

# **RF & MICROWAVE COMPONENTS**

**DATABOOK**

**2<sup>nd</sup> EDITION**

**JANUARY 1993**

## **USE IN LIFE SUPPORT DEVICES OR SYSTEMS MUST BE EXPRESSLY AUTHORIZED**

SGS-THOMSON PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF SGS-THOMSON Microelectronics. As used herein:

1. Life support devices or systems are those which (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform, when properly used in accordance with instructions for use provided with the product, can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can reasonably be expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

# TABLE OF CONTENTS

---

<b>INTRODUCTION</b>	<b>Page</b>	<b>4</b>
---------------------	-------------	----------

---

<b>ALPHANUMERICAL INDEX</b>		<b>7</b>
-----------------------------	--	----------

---

<b>PRODUCTS GUIDE</b>		<b>11</b>
– SYMBOLS		<b>13</b>
– SELECTION GUIDE		<b>14</b>
– CROSS REFERENCE		<b>37</b>

---

<b>DATASHEETS</b>		<b>45</b>
-------------------	--	-----------

---

# INTRODUCTION

---

## SGS-THOMSON MICROELECTRONICS, RF PRODUCTS GROUP

### RF & MICROWAVE COMPONENTS DATABOOK, 2nd Edition

This 2nd Edition DATABOOK of RF & Microwave Components represents a major revision from the 1st edition version.

Included in the new edition are an extensive product line of silicon bipolar microwave power transistors previously manufactured by Microwave Semiconductor Corporation (MSC).

MSC was acquired by SGS-THOMSON and consolidated into the RF Products Group in Montgomeryville, Pennsylvania during 1990.

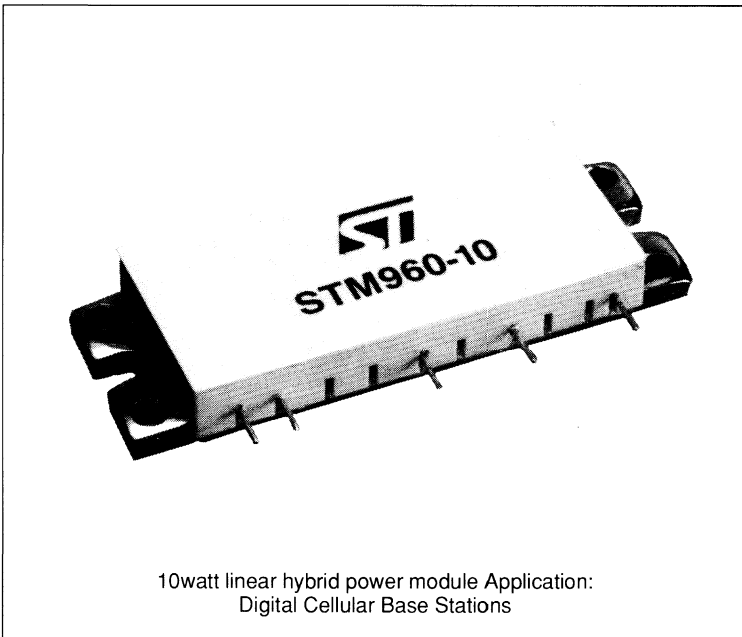
These products continue to carry their original "AM" and "MSC" part number

nomenclatures in order to facilitate their identification in the new databook.

Also included are data sheets covering the newest SGS-THOMSON RF Products Group product line - hybrid power modules for Digital Cellular Telephone and Satellite Communications applications. Silicon RF power MOSFETs and bipolar transistors are combined with hybrid circuitry to yield high-performance, cost-effective amplifier modules easily integratable into new generations of portable, mobile and fixed equipment.

During the last half of 1991 and continuing into the first half of 1992, a product consolidation has taken place, resulting in the deletion from this 2nd edition DATABOOK of many parts which appeared in the 1st edition. On the other hand, many new products have been added along with the MSC product line discussed above.

Another new addition is a comprehensive cross reference chart



10watt linear hybrid power module Application:  
Digital Cellular Base Stations

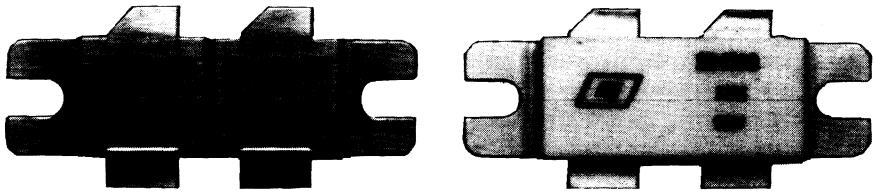
## INTRODUCTION

which lists both current as well as former competitors' part numbers and the nearest SGS-THOMSON equivalent. In some cases, an additional device is suggested as an alternate replacement.

If a part of interest, based on RF performance characteristics, is not shown in the catalog in the package style required for a specific application, please contact us directly or via an authorized sales representative or distributor as it is possible that other package configurations are readily available.

SGS-THOMSON has endeavored to provide complete, accurate technical information in this DATABOOK. We cannot, however, assume responsibility for inaccuracies or omissions.

Please contact an authorized SGS-THOMSON sales representative or distributor or the factory directly if additional information on any product in this DATABOOK is required.



150 watt Class AB linear power transistor Application:  
800/960 MHz Digital Cellular Base Stations



# ALPHANUMERICAL INDEX

Type	Page	Type	Page	Type	Page
2N3375 . . . . .	729	AM1517-035 . . . . .	179	AM81416-020 . . . . .	309
2N3632 . . . . .	737	AM1616-050 . . . . .	185	AM81618-005 . . . . .	30
2N3733 . . . . .	741	AM1618-001 . . . . .	30	AM81618-009 . . . . .	30
2N4440 . . . . .	733	AM1618-003 . . . . .	30	AM81618-010 . . . . .	30
2N5643 . . . . .	779	AM1720-001 . . . . .	30	AM81618-016 . . . . .	30
2N5944 . . . . .	771	AM1720-003 . . . . .	30	AM81618-020 . . . . .	30
2N5946 . . . . .	775	AM1720-006 . . . . .	30	AM81719-030 . . . . .	313
2N6080 . . . . .	683	AM1821-001 . . . . .	30	AM81719-040 . . . . .	317
2N6081 . . . . .	707	AM1821-003 . . . . .	30	AM81720-012 . . . . .	319
2N6084 . . . . .	715	AM1821-006 . . . . .	30	AM81720-020 . . . . .	323
AM0405-030 . . . . .	47	AM1922-001 . . . . .	31	AM81821-010 . . . . .	30
AM0405-100 . . . . .	51	AM1922-003 . . . . .	31	AM81821-018 . . . . .	30
AM0608-020 . . . . .	55	AM1922-006 . . . . .	31	AM81922-010 . . . . .	31
AM0608-070 . . . . .	59	AM2023-001 . . . . .	189	AM81922-018 . . . . .	327
AM0608-200 . . . . .	63	AM2023-003 . . . . .	193	AM82022-020 . . . . .	331
AM0608-450 . . . . .	65	AM2023-006 . . . . .	197	AM82023-010 . . . . .	333
AM0710-300 . . . . .	69	AM2327-001 . . . . .	201	AM82023-016 . . . . .	337
AM0912-050 . . . . .	26	AM2327-003 . . . . .	205	AM82223-004 . . . . .	341
AM0912-080 . . . . .	73	AM2327-005 . . . . .	209	AM82223-010 . . . . .	345
AM0912-150 . . . . .	77	AM2729-110 . . . . .	213	AM82223-012 . . . . .	347
AM0912-300 . . . . .	83	AM2729-125 . . . . .	217	AM82223-014 . . . . .	351
AM0912-350 . . . . .	89	AM2931-110 . . . . .	219	AM82223-018 . . . . .	353
AM1011-050 . . . . .	93	AM2931-125 . . . . .	223	AM82223-020 . . . . .	357
AM1011-055 . . . . .	95	AM3135-007 . . . . .	225	AM82324-020 . . . . .	359
AM1011-060 . . . . .	97	AM3135-014 . . . . .	227	AM82325-040 . . . . .	361
AM1011-070 . . . . .	101	AM3135-025 . . . . .	229	AM82327-004 . . . . .	365
AM1011-075 . . . . .	105	AM3135-035 . . . . .	233	AM82327-006 . . . . .	369
AM1011-175 . . . . .	109	AM3135-045 . . . . .	235	AM82327-010 . . . . .	373
AM1011-225 . . . . .	111	AM3135-25N . . . . .	237	AM82327-015 . . . . .	377
AM1011-350 . . . . .	115	AM80610-018 . . . . .	241	AM82729-030 . . . . .	381
AM1011-400 . . . . .	119	AM80610-030 . . . . .	245	AM82729-060 . . . . .	385
AM1011-500 . . . . .	125	AM80610-050 . . . . .	249	AM82731-001 . . . . .	389
AM1214-100 . . . . .	129	AM80814-005 . . . . .	253	AM82731-003 . . . . .	393
AM1214-175 . . . . .	131	AM80814-025 . . . . .	259	AM82731-006 . . . . .	397
AM1214-200 . . . . .	137	AM80912-005 . . . . .	261	AM82731-012 . . . . .	401
AM1214-300 . . . . .	141	AM80912-015 . . . . .	265	AM82731-025 . . . . .	403
AM1214-325 . . . . .	147	AM80912-030 . . . . .	271	AM82731-050 . . . . .	407
AM1416-001 . . . . .	151	AM80912-085 . . . . .	277	AM82731-075 . . . . .	411
AM1416-003 . . . . .	155	AM81214-006 . . . . .	281	AM82931-055 . . . . .	413
AM1416-100 . . . . .	159	AM81214-015 . . . . .	285	AM82931-055N . . . . .	419
AM1416-200 . . . . .	163	AM81214-030 . . . . .	289	AM82931-055S . . . . .	425
AM1418-001 . . . . .	30	AM81214-006 . . . . .	27	AM83135-001 . . . . .	431
AM1418-003 . . . . .	30	AM81214-060 . . . . .	295	AM83135-003 . . . . .	435
AM1517-012 . . . . .	167	AM81416-006 . . . . .	301	AM83135-005 . . . . .	439
AM1517-025 . . . . .	173	AM81416-012 . . . . .	305	AM83135-010 . . . . .	443

# ALPHANUMERICAL INDEX

Type	Page
AM83135-015 . . . . .	447
AM83135-030 . . . . .	449
AM83135-040 . . . . .	451
AM83135-050 . . . . .	453
MSC1000M . . . . .	459
MSC1000MP . . . . .	463
MSC1002M . . . . .	467
MSC1002MP . . . . .	473
MSC3000 . . . . .	479
MSC4000 . . . . .	485
MSC4001 . . . . .	489
MSC4003 . . . . .	493
MSC80064 . . . . .	497
MSC80185 . . . . .	503
MSC80186 . . . . .	509
MSC80195 . . . . .	515
MSC80196 . . . . .	521
MSC80197 . . . . .	527
MSC80264 . . . . .	533
MSC81002 . . . . .	539
MSC81005 . . . . .	543
MSC81010 . . . . .	547
MSC81020 . . . . .	551
MSC81035M . . . . .	555
MSC81035MP . . . . .	559
MSC81058 . . . . .	563
MSC81111 . . . . .	567
MSC81118 . . . . .	571
MSC81150M . . . . .	575
MSC81175M . . . . .	579
MSC81250M . . . . .	583
MSC81300M . . . . .	587
MSC81325M . . . . .	591
MSC81350M . . . . .	595
MSC81390M . . . . .	599
MSC81400M . . . . .	603
MSC81402 . . . . .	607
MSC81406 . . . . .	609
MSC81410 . . . . .	611
MSC81450M . . . . .	613
MSC81550M . . . . .	617
MSC81600M . . . . .	621
MSC82001 . . . . .	627
MSC82003 . . . . .	631
MSC82005 . . . . .	635

Type	Page
MSC82010 . . . . .	639
MSC82040 . . . . .	643
MSC82100 . . . . .	649
MSC82302 . . . . .	655
MSC82304 . . . . .	659
MSC82306 . . . . .	663
MSC82307 . . . . .	667
MSC83301 . . . . .	671
MSC83303 . . . . .	675
MSC83305 . . . . .	679
SD1012 . . . . .	683
SD1012-03 . . . . .	687
SD1013 . . . . .	691
SD1013-03 . . . . .	699
SD1014-02 . . . . .	707
SD1014-06 . . . . .	711
SD1018 . . . . .	715
SD1018-06 . . . . .	719
SD1019 . . . . .	723
SD1050 . . . . .	729
SD1060 . . . . .	733
SD1070 . . . . .	737
SD1075 . . . . .	741
SD1134 . . . . .	745
SD1134-05 . . . . .	749
SD1135 . . . . .	753
SD1135-03 . . . . .	757
SD1143 . . . . .	761
SD1143-01 . . . . .	767
SD1144 . . . . .	771
SD1146 . . . . .	775
SD1224 . . . . .	779
SD1224-02 . . . . .	783
SD1224-10 . . . . .	787
SD1273 . . . . .	791
SD1274 . . . . .	795
SD1274-01 . . . . .	799
SD1275 . . . . .	803
SD1275-01 . . . . .	807
SD1285 . . . . .	811
SD1398 . . . . .	815
SD1400-02 . . . . .	821
SD1400-03 . . . . .	827
SD1405 . . . . .	831
SD1407 . . . . .	835

Type	Page
SD1411 . . . . .	839
SD1414 . . . . .	843
SD1420 . . . . .	849
SD1420-01 . . . . .	853
SD1422 . . . . .	857
SD1423 . . . . .	863
SD1424 . . . . .	867
SD1425 . . . . .	873
SD1426 . . . . .	877
SD1428 . . . . .	881
SD1429 . . . . .	887
SD1429-03 . . . . .	891
SD1433 . . . . .	895
SD1434 . . . . .	901
SD1437 . . . . .	907
SD1439 . . . . .	911
SD1446 . . . . .	915
SD1448 . . . . .	921
SD1449 . . . . .	927
SD1455 . . . . .	931
SD1456 . . . . .	935
SD1457 . . . . .	941
SD1458 . . . . .	945
SD1459 . . . . .	949
SD1460 . . . . .	955
SD1462 . . . . .	961
SD1463 . . . . .	965
SD1464 . . . . .	969
SD1468 . . . . .	973
SD1470 . . . . .	977
SD1474 . . . . .	981
SD1476 . . . . .	985
SD1477 . . . . .	993
SD1480 . . . . .	999
SD1483 . . . . .	1005
SD1485 . . . . .	1011
SD1487 . . . . .	1019
SD1488 . . . . .	1025
SD1489 . . . . .	1029
SD1490 . . . . .	1035
SD1492 . . . . .	1041
SD1495-03 . . . . .	1049
SD1496 . . . . .	1053
SD1496-03 . . . . .	1057
SD1511-08 . . . . .	1061



# ALPHANUMERICAL INDEX

Type	Page
SD1512 . . . . .	1065
SD1526-01 . . . . .	1071
SD1526-08 . . . . .	1075
SD1527-08 . . . . .	1079
SD1528-06 . . . . .	1083
SD1528-08 . . . . .	1087
SD1530-01 . . . . .	1091
SD1530-08 . . . . .	1095
SD1534-01 . . . . .	1101
SD1534-08 . . . . .	1105
SD1536-03 . . . . .	1109
SD1536-08 . . . . .	1113
SD1538-02 . . . . .	1117
SD1538-08 . . . . .	1123
SD1540 . . . . .	1129
SD1540-08 . . . . .	1135
SD1541-01 . . . . .	1141
SD1541-09 . . . . .	1147
SD1542 . . . . .	1151
SD1542-04 . . . . .	1155
SD1550 . . . . .	1161
SD1563 . . . . .	1165
SD1564 . . . . .	1173
SD1565 . . . . .	1177
SD1650 . . . . .	1183
SD1658 . . . . .	1189
SD1660 . . . . .	1195
SD1680 . . . . .	1201
SD1726 . . . . .	1209
SD1727 . . . . .	1217
SD1728 . . . . .	1225
SD1729 . . . . .	1235
SD1730 . . . . .	1239
SD1731 . . . . .	1245
SD1732 . . . . .	1253
SD1733 . . . . .	1259
SD1850 . . . . .	1263
SD1851 . . . . .	1267
SD1853 . . . . .	1271
SD1855 . . . . .	1275
SD1868 . . . . .	1279
SD1888-03 . . . . .	1285
SD1891-03 . . . . .	1289
SD1893-03 . . . . .	1295
SD1895-03 . . . . .	1301

Type	Page
SD1897 . . . . .	1305
SD1898 . . . . .	1309
SD1920 . . . . .	1313
SD1920-02 . . . . .	1317
SD1930 . . . . .	1321
SD4010 . . . . .	1327
SD4011 . . . . .	1333
SD4012 . . . . .	1339
SD4013 . . . . .	1345
SD4017 . . . . .	1351
SD4590 . . . . .	1357
SD4600 . . . . .	1363
SD4701 . . . . .	21
SD5000 . . . . .	1367
SD8250 . . . . .	1371
STM900-30 . . . . .	1375
STM915-14 . . . . .	1381
STM960-10 . . . . .	1387
STM960-15 . . . . .	1393
STM1645-30 . . . . .	1397
TCC20L08 . . . . .	1267
TCC20L15 . . . . .	1271
TCC20L25 . . . . .	1275
TCC0105-100 . . . . .	969
TCC0204-125 . . . . .	965
TCC597 . . . . .	927
TCC598 . . . . .	921
TDS595 . . . . .	1253
TH416 . . . . .	1235
TH430 . . . . .	1225
TH513 . . . . .	1259
TH560 . . . . .	1239
TH562 . . . . .	1245
THA15 . . . . .	1209
THX15 . . . . .	1217



# **PRODUCTS GUIDE**



<b>BYCBO</b>	Collector-base breakdown voltage
<b>BYCEO</b>	Collector-emitter breakdown voltage, base open
<b>BYCES</b>	Collector-emitter breakdown voltage
<b>BVEBO</b>	Emitter-base breakdown voltage
<b>CB</b>	Common base
<b>CC</b>	Common collector
<b>CE</b>	Common emitter
<b>CS</b>	Common source
<b>COB</b>	Output capacitance
<b>CMD</b>	Cross modulation distortion
<b>DC</b>	Duty cycle
<b>f<sub>t</sub></b>	Test frequency
<b>f<sub>T</sub></b>	Transition frequency
<b>g<sub>m</sub></b>	Forward transconductance
<b>GP</b>	Power gain
<b>h<sub>FE</sub></b>	DC Current gain
<b>I<sub>B</sub></b>	Continuous base current
<b>I<sub>C</sub></b>	Continuous collector current
<b>I<sub>CBO</sub></b>	Collector-base cutoff current
<b>I<sub>CES</sub></b>	Collector-emitter cutoff current
<b>I<sub>CO</sub></b>	Quiescent collector current
<b>I<sub>DSS</sub></b>	Drain-source leakage current
<b>I<sub>GSS</sub></b>	Gate-source leakage current
<b>IMD</b>	Intermodulation distortion
<b>η<sub>C</sub></b>	Collector efficiency
<b>η<sub>D</sub></b>	Drain efficiency
<b>NF</b>	Noise figure
<b>POISS</b>	Total power dissipation
<b>P<sub>IN</sub></b>	Input power
<b>P<sub>OUT</sub></b>	Output power
<b>P<sub>OUT(PEP)</sub></b>	Output peak envelope power
<b>P<sub>SYNC. P<sub>REF</sub></sub></b>	Peak sync output power
<b>PW</b>	Pulse width
<b>R<sub>TH(j-c)</sub></b>	Thermal resistance (junction-case)
<b>V<sub>CB</sub></b>	Collector-base continuous voltage
<b>V<sub>CC</sub></b>	Collector DC supply voltage
<b>V<sub>CE</sub></b>	Collector-emitter continuous voltage
<b>V<sub>DS</sub></b>	Drain-source continuous voltage
<b>V<sub>GS(th)</sub></b>	Gate threshold voltage

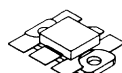
## SELECTION GUIDE



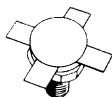
.380 4LFL  
(M113)



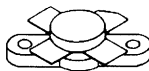
.380 4L STUD  
(M135)



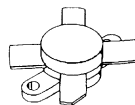
.400 x .425 6LFL  
(M153)



.500 Dia - .550 4L STUD  
(M164)



.500 4LFL  
(M174)



.550 4LFL  
(M177)

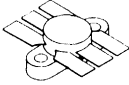
### 2-30 MHz CLASS AB LINEAR, COMMON EMITTER, HF/SSB

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> (PEP) MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	BIAS		R <sub>TH(j-c)</sub> MAX (°C/W)	IMD <sub>2</sub> TONES (dBc)	PACKAGE STYLE
					V <sub>CE</sub> (V)	I <sub>CO</sub> (mA)			
SD1285*	30	20	0.65	15	12.5	25	2.2	-30	M113
SD1405*	30	75	3.8	13	12.5	100	0.65	-32	M174
SD1487	30	100	7.9	11	12.5	150	0.6	-30	M174
SD1224-10*	30	30	0.5	18	28	25	2.2	-28	M113
SD1407*	30	125	4	15	28	100	0.65	-30	M174
SD1729	30	130	8.2	12	28	150	1.0	-30	M174
SD1730	30	220	14	12	28	750	0.7	-30	M174
SD1411	30	200	5	16	40	150	0.35	-30	M153
SD1733	30	75	3	14	50	—	2.0	-30	M135
SD1726	30	150	6	14	50	100	0.75	-30	M174
SD1727	30	150	6	14	50	100	0.75	-30	M164
SD1731	30	220	11	13	50	150	0.70	-30	M174
SD1728	30	250	10	14	50	150	0.40	-30	M177

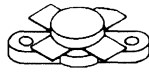
\*Tested Class C

#### P/N Cross Reference

INDUSTRY P/N	SD P/N
TH416	SD1729
TH430	SD1728
TH513	SD1733
TH560	SD1730
TH562	SD1731
THA15	SD1726
THX15	SD1727



.500 6LFL  
(M111)



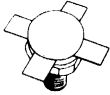
.380 4LFL  
(M113)



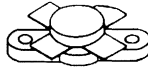
.500 4L STUD  
(M130)



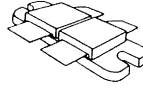
.380 4L STUD  
(M135)



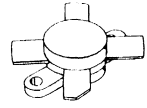
.500 Dia - .550 4L STUD  
(M164)



.500 4LFL  
(M174)



2 x .437 x .450 2LFL  
(M175)



.550 4LFL  
(M177)

**27-88 MHz CLASS C, COMMON EMITTER, LOW & MID-BAND FM**

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1446	50	70	7	10	12.5	1.05	M113
SD1405	50	100	20	7	12.5	0.65	M174
SD1726	70	150	19	9	50	0.75	M174
SD1727	70	150	19	9	50	0.75	M164
SD1728	70	250	25	10	50	0.40	M177

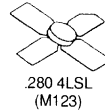
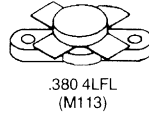
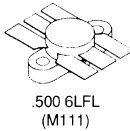
**88-108 MHz CLASS C, COMMON EMITTER, FM BROADCAST**

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>c</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1457	108	75	7.5	10	70	28	1.5	M174
SD1460	108	150	18	9.2	70	28	0.75	M174
SD1483	108	300	30	10	60	28	0.45	M175

**108-150 MHz CLASS C, COMMON EMITTER, AIRCRAFT COMMUNICATIONS**

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1013	150	3	0.3	10	13.5	13.5	M135
SD1013-03	150	3	0.3	10	13.5	13.5	M113
SD1019	150	30	10.6	4.5	13.5	1.7	M130
SD1480	136-175	12.5	15	9.2	28	0.65	M111

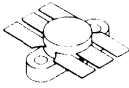
## SELECTION GUIDE



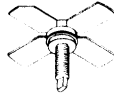
### 150-175 MHz CLASS C, COMMON EMITTER, HIGH BAND FM

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1134-05	150	1.4	0.1	11.5	—	7.5	35	M123
SD1135-03	150	2.5	0.2	11	—	7.5	11.6	M123
SD1274	160	30	3	10	—	13.6	1.2	M135
SD1274-01	160	30	3	10	—	13.6	1.2	M113
SD1275	160	40	5	9	—	13.6	1.2	M135
SD1275-01	160	40	5	9	—	13.6	1.2	M113
SD1273	160	40	5	9	55	13.6	2.5	M135
SD1012	175	4	0.25	12	50	12.5	15	M135
SD1012-03	175	6	0.75	9	50	12.5	8.75	M113
SD1143	175	10	1	10	—	12.5	8.75	M135
SD1143-01	175	10	1	10	—	12.5	8.75	M113
SD1014-02	175	15	3.5	6.3	60	12.5	5.6	M135
SD1014-06	175	15	3.5	6.3	60	12.5	5.6	M113
SD1018	175	40	14	4.5	70	12.5	2.2	M135
SD1018-06	175	40	14	4.5	70	12.5	2.2	M113
SD1428	175	45	10	6.5	50	12.5	1.2	M111
SD1477	175	100	25	6	—	12.5	0.65	M111
SD1070	175	13.5	3.5	5.8	70	28	7.6	M137
SD1224	175	40	7	7.6	60	28	2.9	M135
SD1224-02	175	40	7	7.6	60	28	2.9	M113

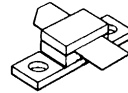




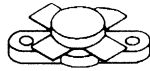
.500 6LFL  
(M111)



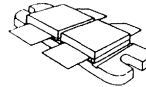
.280 4L STUD  
(M122)



.230 x .360 2LFL  
(M159)



500 4LFL  
(M174)



2 x .437 x .450 2LFL  
(M176)

## 2-400 MHz COMMON SOURCE N CHANNEL MOSFETS

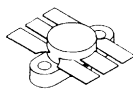
PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>D</sub> (%)	BIAS		R <sub>TH(j-c)</sub> MAX. (°C/W)	PACKAGE STYLE
						V <sub>DD</sub> (V)	I <sub>DD</sub> (mA)		
SD1920	150	150	24	8	45	50	250	0.7	M174
SD1920-02	150	300	47.5	8	45	50	2 x 250	0.7	M176
SD1930	400	5	0.3	12	45	28	50	5.0	M159

## 450-512 MHz CLASS C, COMMON EMITTER, FM MOBILE

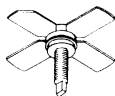
PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN (dB)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX. (°C/W)	PACKAGE STYLE
SD1144	470	2	0.25	9.0	12.5	35.0	M122
SD1134	470	2	0.20	10.0	12.5	35.0	M122
SD1135	470	5	0.70	8.5	12.5	11.6	M122
SD1433	470	10	2.0	7.0	12.5	3.0	M122
SD1146	470	10	2.5	6.0	12.5	4.7	M122
SD1429	470	12	2.0	7.8	12.5	4.6	M111
SD1429-03	470	15	2.5	7.8	12.5	4.6	M111
SD1422	470	25	6.0	6.2	12.5	2.5	M111
SD1488	470	38	10.0	5.8	12.5	1.5	M111
SD1434	470	45	14.0	5.0	12.5	1.0	M111

P/N Cross Reference	
INDUSTRY P/N	SD P/N
2N5944	SD1144
2N5946	SD1146

## SELECTION GUIDE



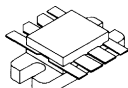
.500 6LFL  
(M111)



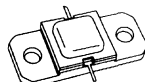
.280 4L STUD  
(M122)



TO 60  
(M137)



.400 x .425 8LFL  
(M168)



.400 x .400 2NFL  
(S042)

### 100-500 MHz CLASS C, COMMON EMITTER

PART NO.	FREQ. (MHz)	POUT MIN. (W)	PIN (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	VCC (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	COB MAX (pF)	PACKAGE STYLE
SD1050	400	3	1.0	4.7	40	28	15.0	10	M137
SD1060	400	5	1.7	4.7	45	28	15.1	10	M137
SD1075	400	10	4.0	4.0	45	28	7.6	20	M137
SD4012	225-400	3	0.2	11.7	60 <sup>(1)</sup>	28	16.0	6	M122
SD4013	225-400	25	3.15	9.0	50	28	2.5	30	M111
SD1462	225-400	70	8.8	9.0	60 <sup>(1)</sup>	28	0.8	65 <sup>(1)</sup>	M111
SD1468	225-400	70	10.0	8.4	60 <sup>(1)</sup>	28	1.25	80	M111
SD1470	225-400	100	20.0	7.0	60 <sup>(1)</sup>	28	0.70	100 <sup>(1)</sup>	M111
SD1463	225-400	125	25.0	7.0	60	28	0.65	—	M168
SD1464	100-500	100	28.2	5.5	55	28	0.67	—	M168

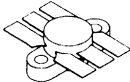
(1) Typical value

#### P/N Cross Reference

INDUSTRY P/N	SD P/N
2N3375	SD1050
2N4440	SD1060
2N3733	SD1075
TCC0105-100	SD1464
TCC0204-125	SD1463

### 500-1000 MHz CLASS C, COMMON BASE

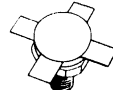
PART NO.	FREQ. (MHz)	POUT MIN. (W)	PIN (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	VCC (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
AM80610-018	620-960	18	2.5	8.6	48	28	4.0	S042
AM80610-030	620-960	30	4.2	8.5	50	28	2.6	S042
AM80610-050	750-960	50	7.0	8.5	50	28	1.8	S042



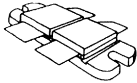
.500 6LFL  
(M111)



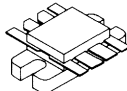
.500 4L STUD  
(M130)



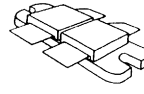
.500 Dia - .550 4L STUD  
(M164)



2 x .437 x .450 2LFL  
(M165)



.400 x .425 8LFL  
(M168)



2 x .437 x .450 2LFL  
(M175)

## 55-88 MHz CLASS AB, COMMON EMITTER, VHF TV BAND I

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>c</sub> MIN (%)	BIAS		R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
						V <sub>CE</sub> (V)	I <sub>c</sub> (mA)		
SD1476	55-88	240	20	12.0	50	32	2 x 400	0.4	M165

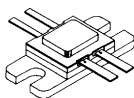
## 174-230 MHz CLASS A, COMMON EMITTER, VHF TV BAND III

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	BIAS		IND <sub>3</sub> TONES (dBc)	R <sub>TH(j-c)</sub> MAX (°C/W)	C <sub>OB</sub> MAX (pF)	PACKAGE STYLE
					V <sub>CE</sub> (V)	I <sub>c</sub> (mA)				
SD1458	225	14	0.55	14	28	2500	-55	1.5	80	M111
SD1455	225	20	3.2	8	25	2500	-51	1.5	85	M130
SD1459	225	30	5.3	7.5	28	3500	-53	1.2	150	M164
SD1456*	225	100	8.0	11.0	28	2 x 100	-51	1.2	80	M168
SD1485*	230	200	16	11.0	32	2 x 500	—	0.45	—	M175

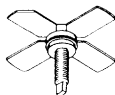
\*Class AB

P/N Cross Reference	
INDUSTRY P/N	SD P/N
TCC3100	SD1456

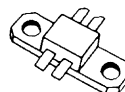
# SELECTION GUIDE



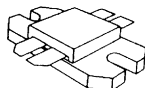
.400 x .425 4LFL  
(M119)



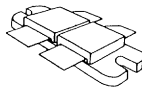
.280 4L STUD  
(M122)



.250 x .320 4LFL  
(M156)



.438 x .450 4LFL  
(M173)



2 x .437 x .450 2LFL  
(M175)

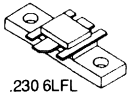
## 470-860 MHz CLASS A, COMMON EMITTER, UHF TV-BANDS

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	BIAS		IMD <sub>3</sub> TONES (dBC)	R <sub>TH(j-c)</sub> MAX (°C/W)	C <sub>OB</sub> MAX (pF)	PACKAGE STYLE
					V <sub>CE</sub> (V)	I <sub>c</sub> (mA)				
SD1439	860	.5	0.56	9.5	20	220	-58	5.5	5	M122
SD1449	860	1	0.1	10	20	440	-58	9.0	7	M122
SD1437	860	2	0.3	8.5	25	450	-60	11	10	M122
SD1448	860	4	0.8	7	25	850	-60	5.5	20	M122
SD4011	860	4	0.63	8.0	25	850	-60	5.5	20	M122
SD1732	860	14	1.2	8.5	25	2 x 850	-45	2.5	17.5 <sup>(1)</sup>	M156
SD4010	860	20	2.2	9.5	26.5	2 x 1350	-48	1.9	36	M119
SD1490	860	25	4.0	8.0	25	2 x 1600	-45	1.3	80	M173
SD1489*	860	50	10.5	6.8	28	2 x 250	—	1.0	70 <sup>(1)</sup>	M173
SD1492*	860	150	33.5	6.5	28	2 x 500	—	0.55	100	M175

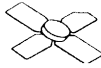
\*Class AB (1)Typical value

P/N Cross Reference	
INDUSTRY P/N	SD P/N
TCC596	SD1439
TCC597	SD1449
TCC593	SD1437

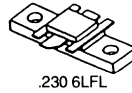
P/N Cross Reference	
INDUSTRY P/N	SD P/N
TCC598	SD1448
TDS595	SD1732



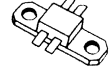
.230 6LFL  
(M118)



.280 4LSL  
(M123)



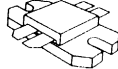
.230 6LFL  
(M142)



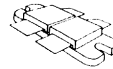
.250 x .320 4LFL  
(M156)



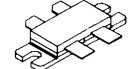
.400 x .425 6LFL  
(M169)



.438 x .450 4LFL  
(M173)



2 x .437 x .450 2LFL  
(M175)



.400 x .860 4LFL  
(M208)

806-960 MHz CLASS C, COMMON BASE, FM MOBILE/BASE STATION

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>c</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1414	836	45	15	4.7	—	12.5	1.2	M142
SD1400-02	900	14	1.5	9.7	55 <sup>(1)</sup>	24	3.0	M118
SD1496	900	60	10.6	7.5	50 <sup>(1)</sup>	24	0.9	M142
SD1426	900	60	12	7.0	55	24	1.0	M169
SD1400-03	960	14	1.6	9.5	50	24	3.5	M118
SD1495-03	960	30	6	7.0	50	24	1.5	M142
SD1496-03	960	55	10	7.4	50 <sup>(1)</sup>	24	0.9	M142

(1) Typical performance

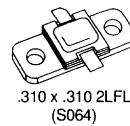
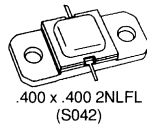
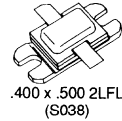
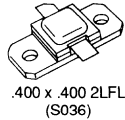
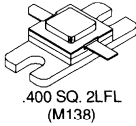
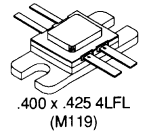
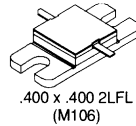
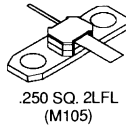
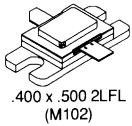
860-960 MHz CLASS AB LINEAR, COMMON EMITTER, CELLULAR BASE STATION

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	BIAS		R <sub>TH(j-c)</sub> MAX (°C/W)	C <sub>OB</sub> MAX (pF)	PACKAGE STYLE
					V <sub>CE</sub> (V)	I <sub>c</sub> (mA)			
SD1420-01*	860-960	0.9	0.10	9.5	24	125	20	5	M123
SD1420*	860-960	2.1	0.27	9	24	200	20	5	M122
SD1398	860-960	6	0.60	10	24	25	3.3	8.5	M142
SD1423	860-960	15	2.4	8	24	75	6.0	25	M118
SD1424	860-960	30	5.3	7.5	24	150	3.0	25	M156
SD1425	860-960	30	5.3	7.5	24	150	3.0	48	M142
SD4017	860-960	30	5.3	7.5	25	60	2.0	42**	M142
SD1658	860-900	40	10	6	24	2 x 250	1.0	80	M173
SD4701	860-960	45	7.15	8	26	200	1.0	45**	M169
SD1650	860-960	60	12	7	24	300	1.5	—	M169
SD4600	860-960	60	10.5	7.5	26	200	1.2	—	M173
SD1660	860-900	120	30	6	24	2 x 400	0.55	100	M175
SD1680	915-960	100	25	6	24	2 x 400	0.55	100	M175
SD4590	800-960	150	24	8	26	2 x 150	0.60	75**	M208

\* Class A

\*\* Typical Value

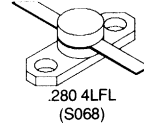
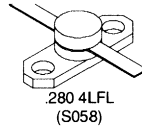
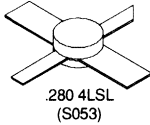
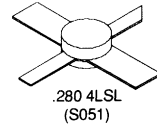
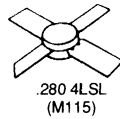
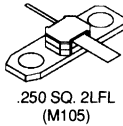
## SELECTION GUIDE



### 400-950 MHz CLASS C, COMMON BASE, PULSED, UHF RADAR APPLICATIONS

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PULSE WIDTH (μSEC)	DUTY CYCLE (%)	PACKAGE STYLE
SD1511-08*	425	10	1.2	9.2	50	28	3.0	CW	CW	M105
SD1474*	425	48	10	6.8	50	28	2.0	CW	CW	M138
SD1563	400-500	300	33	9.6	50	40	0.20	250	10	M106
SD1564	400-500	400	80	7.0	50	40	0.15	60	2	M119
SD1565	400-500	500	54	9.7	50	40	0.15	250	10	M102
AM0405-030	420-450	30	3.5	9.3	60	32	4.0	10,000	20	S042
AM0405-100	420-450	100	16	8.0	60	32	1.5	10,000	20	S042
AM0608-020	600-750	20	2.5	9.0	40	35	1.5	10	1	S064
AM0608-070	600-750	70	13	7.3	35	50	0.60	10	1	S064
AM0608-200	600-750	220	30	8.7	40	50	0.20	10	1	S042
AM0608-450	600-750	445	90	6.9	40	50	0.13	10	1	S038
AM0710-300	750-950	300	40	8.8	40	50	0.22	10	10	S036

\* Common Emitter

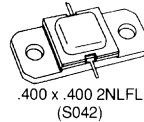
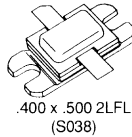
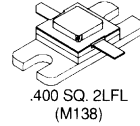
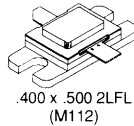
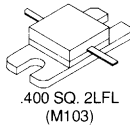


1025-1150 MHz CLASS C, COMMON BASE, PULSED, DME/TACAN

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>c</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
MSC1000M*	1025-1150	0.6	0.05	9.0	CL.A	18	35	S058
MSC1000MP*	1025-1150	0.6	0.05	9.0	CL.A	18	35	S053
MSC1002M	1025-1150	2	0.25	9.0	35	35	10	S068
MSC1002MP	1025-1150	2	0.25	9.0	35	35	10	S051
SD1526-01	1025-1150	5	0.55	9.5	—	28	8	M115
SD1526-08	1025-1150	5	0.55	9.5	—	28	8	M105
SD1528-06	1025-1150	15	1.5	10.0	30	50	2	M115
SD1528-08	1025-1150	15	1.5	10.0	30	50	2	M105
MSC81035M	1025-1150	35	3	10.6	43	50	1	S068
MSC81035MP	1025-1150	35	3	10.6	43	50	1	S051
SD1530-01	1025-1150	35	5.6	8.0	30	50	2	M115
SD1530-08	1025-1150	35	5.0	8.5	30	50	2	M105
SD1534-01	1025-1150	75	13	7.6	—	50	0.8	M115
SD1534-08	1025-1150	75	13.5	7.4	—	50	0.8	M105
SD1536-03	1025-1150	90	13	8.4	—	50	0.6	M115
SD1536-08	1025-1150	90	13	8.4	—	50	0.6	M105

\*Common Emitter, Tested CW  
Pulse Conditions 10μSec, 1% Duty Cycle unless otherwise specified

# SELECTION GUIDE

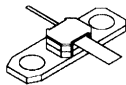
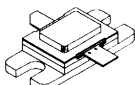
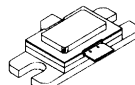
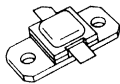
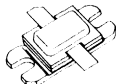
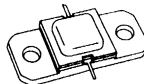


## 1025-1150 MHz CLASS C, COMMON BASE, PULSED, DME/TACAN (CONT'D)

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>C</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1538-02	1025-1150	150	25	7.8	—	50	0.3	M103
SD1538-08	1025-1150	150	25	7.8	—	50	0.3	M138
MSC81150M	1025-1150	150	25	7.7	40	50	0.3	S042
MSC81175M	1025-1150	175	30	7.6	40	50	0.3	S042
MSC81250M	1025-1150	250	60	6.2	40	50	0.2	S042
MSC81325M	1025-1150	325	70	6.7	40	50	0.17	S042
SD1540	1025-1150	300	70	6.3	35	50	0.2	M103
SD1540-08	1025-1150	300	70	6.3	35	50	0.2	M138
SD1541-01	1025-1150	400	90	6.5	—	50	0.12	M112
MSC81400M	1025-1150	400	90	6.5	40	50	0.12	S038
SD1542	1025-1150	550	150	5.6	—	50	0.06	M112
MSC81550M	1025-1150	550	150	5.6	35	50	0.09	S038

Pulse Conditions 10μSec, 1% Duty Cycle unless otherwise specified



250 SQ. 2LFL  
(M105)400 x 500 2LFL  
(M112)400 x 600 2LFL  
(M198).400 x .400 2LFL  
(S036)400 x 500 2LFL  
(S038)400 x 400 2NFL  
(S042)**1030/1090 MHz CLASS C, COMMON BASE PULSED, IFF APPLICATIONS**

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>c</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1527-08	1090	5	0.35	11.5	—	50	8.0	M105
MSC81300M	1090	300	70	6.3	40	50	0.2	S042
MSC81350M	1090	350	70	6.9	40	50	0.17	S042
MSC81390M	1090	390	80	6.8	35	50	0.15	S042
SD1541-09	1090	450	90	7.0	—	50	0.12	M112
MSC81450M	1090	450	90	7.0	40	50	0.12	S038
SD1542-04	1090	600	150	6.0	—	50	0.06	M112
MSC81600M	1090	600	150	6.0	35	50	0.09	S038

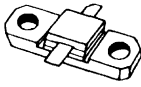
Pulse Conditions 10μSec, 1% Duty Cycle unless otherwise specified

**1030/1090 MHz CLASS C, COMMON BASE PULSED, SPECIAL APPLICATIONS (MODE-S, TCAS)**

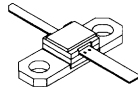
PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>c</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PULSE WIDTH (μSEC)	DUTY CYCLE (%)	PACKAGE STYLE
AM1011-055	1090	55	6.6	9.2	48	50	1.1	32	2	S036
AM1011-075	1090	75	9	9.2	48	50	0.86	32	2	S036
AM1011-175	1090	200	32	8.0	45	50	0.28	32	2	S036
AM1011-400	1090	400	63	8.0	45	50	0.17	32	2	S038
AM1011-500*	1090	500	70	8.5	40	50	0.11	32	2	M198
AM1011-070	1090	70	15	6.7	45	28	0.68	100	2	S042
AM1011-060	1090	60	6	10.0	48	50	1.10	100	4	S036
AM1011-350*	1090	350	60	7.7	48	50	0.23	100	4	S038
AM1011-050	1030	45	6	8.8	48	36	1.4	250	6	S036
AM1011-225	1030	225	40	7.5	48	36	0.29	250	6	S038

\*In development

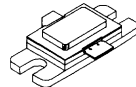
## SELECTION GUIDE



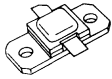
.250 SQ. 2LFL  
(M124)



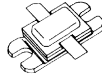
.250 x .250 2LFL  
(M171)



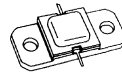
400 x .600 2LFL  
(M198)



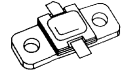
.400 x .400 2LFL  
(S036)



.400 x .500 2LFL  
(S038)



.400 x .400 2NLFL  
(S042)



.310 x .310 2LFL  
(S064)

### 960-1215 MHz CLASS C, COMMON BASE, PULSED, TACAN APPLICATIONS

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PULSE WIDTH (μSEC)	DUTY CYCLE (%)	PACKAGE STYLE
SD1550	960-1215	15	1.5	10.0	40	40	3.3	20	10	M171
AM0912-080	960-1215	90	13	8.4	38	50	0.80	10	10	S042
SD8250	960-1215	250	40	8.0	38	50	0.28	20	5	S036
AM0912-300	960-1215	300	60	7.0	38	50	0.16	10	10	S038
AM0912-350*	960-1215	350	70	7.0	38	50	0.15	10	10	M198

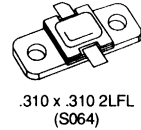
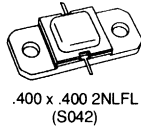
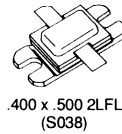
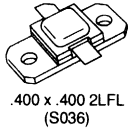
\*In development

### 960-1215 MHz CLASS C, COMMON BASE, PULSED, JTIDS/MIDS/TACAN APPLICATIONS

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1512*	960-1215	5	1.0	7.0	—	30	3.3	M124
AM80912-005	960-1215	6	0.7	9.3	45	28	7.0	S064
AM80912-015	960-1215	15	2.3	8.1	45	28	3.0	S064
AM80912-030	960-1215	30	5.0	7.8	40	35	2.2	S036
AM0912-050	960-1215	50	8.9	7.5	40	35	1.5	S042
AM80912-085	960-1215	85	15	7.5	40	35	0.75	S042
AM0912-150	960-1215	150	26.7	7.5	45	35	0.57	S038

Note: Devices are characterized and tested under JTIDS pulse burst conditions.

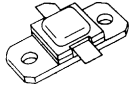
\* 400μSec, 20%



**850-1550 MHz CLASS C, PULSED, L-BAND RADAR APPLICATIONS**

PART NO.	FREQ. (MHz)	POUT (W)	PN (dB)	GAIN (dB)	TC (%)	VCC (V)	RTH(I-c) MAX (°C/W)	PULSE WIDTH (μSEC)	DUTY CYCLE (%)	PACKAGE STYLE
AM80814-005	850-1400	5.0	0.7	8.5	40	28	6.5	120	4	S064
AM80814-025	850-1400	25	5.0	7.0	38	35	2.3	120	4	S036
AM1214-300	1235-1365	300	63	6.3	40	50	0.24	50	4	S038
AM81214-006	1215-1400	5.5	0.7	9.0	47	28	9.0	1000	10	S064
AM81214-015	1215-1400	14.5	2.0	8.6	48	28	4.0	1000	10	S064
AM81214-030	1215-1400	26	5.0	7.2	45	28	2.4	1000	10	S064
AM81214-060	1215-1400	55	12	6.6	50	28	1.4	1000	10	S042
AM1214-100	1215-1400	100	25	6.0	50	28	0.55	100	10	S038
AM1214-175	1215-1400	160	30	7.3	45	40	0.45	150	5	S038
AM1214-200	1215-1400	200	40	7.0	45	40	0.23	150	5	M205
AM1214-325	1215-1400	325	75	6.4	38	50	0.10	13	2	S038
AM1416-100	1400-1550	90	15	7.8	40	45	0.25	10	10	S042
AM1416-200	1400-1550	180	40	6.5	40	50	0.11	10	10	S042

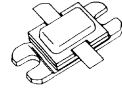
## SELECTION GUIDE



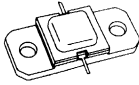
.400 x .400 2LFL  
(S036)



.400 x .400 2L  
(S037)



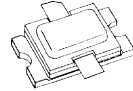
.400 x .500 2LFL  
(S038)



.400 x .400 2NLFL  
(S042)



.400 x .400 2L SFL  
(S136)

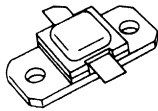
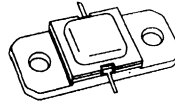
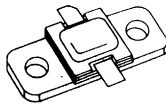
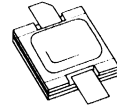


.400 x .500 2NL SFL  
(S138)

### 2300-3500 MHz CLASS C, COMMON BASE, PULSED, S-BAND RADAR

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PULSE WIDTH (μSEC)	DUTY CYCLE (%)	PACKAGE STYLE
AM82325-040	2300-2500	40	10	6.0	40	35	0.90	10	20	S036
AM82729-030	2700-2900	28	6.3	6.5	30	40	1.4	50	10	S036
AM82729-060	2700-2900	60	13	6.6	35	40	0.50	50	10	S036
AM2729-110	2700-2900	105	23.5	6.5	33	40	0.4	50	10	S138
AM2729-125*	2700-2900	125	25	7.0	35	40	0.35	50	10	S038
AM82731-001	2700-3100	1.0	0.30	5.2	27	30	13.0	100	10	S042
AM82731-003	2700-3100	3.0	0.80	5.7	27	30	6.5	100	10	S042
AM82731-006	2700-3100	5.5	1.5	5.6	27	30	3.75	100	10	S042
AM82731-012	2700-3100	12	3.0	6.0	30	40	4.0	100	10	S036
AM82731-025	2700-3100	25	6.0	6.2	30	40	2.0	100	10	S036
AM82731-050	2700-3100	50	12.5	6.0	30	40	0.75	100	10	S036
AM82731-075*	2700-3100	75	15	7.0	35	40	0.6	100	10	S038
AM82931-055	2900-3100	55	13.5	6.1	32	42	0.50	50	10	S036
AM82931-55S	2900-3100	55	13.5	6.1	32	42	0.50	50	10	S136
AM82931-55N	2900-3100	55	13.5	6.1	32	42	0.50	50	10	S037
AM2931-110	2900-3100	105	25	6.2	32	42	0.40	50	10	S138
AM2931-125*	2900-3100	125	25	7.0	35	42	0.35	50	10	S038

\*In development

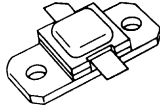
400 x .400 2LFL  
(S036)400 x .400 2NLFL  
(S042).310 x .310 2LFL  
(S064).310 x .310 2L  
(S065)

## 2300-3500 MHz CLASS C, COMMON BASE, PULSED, S-BAND RADAR

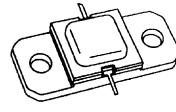
PART NO.	FREQ. (MHz)	P <sub>OUT</sub>	P <sub>IN</sub>	GAIN	$\eta_c$	V <sub>CC</sub>	R <sub>TH(j-c)</sub>	PULSE	DUTY	PACKAGE STYLE
		MIN (W)	(W)	MIN (dB)	MIN (%)	(V)	MAX (°C/W)	WIDTH (μSEC)	CYCLE (%)	
AM83135-001	3100-3500	1.0	0.30	5.2	27	30	13.0	100	10	S042
AM83135-003	3100-3500	3.0	0.80	5.7	27	30	6.5	100	10	S042
AM83135-005	3100-3500	5.0	1.5	5.2	27	30	3.75	100	10	S042
AM83135-010	3100-3500	10	3.2	5.0	30	40	4.0	100	10	S064
AM83135-015	3100-3500	15	4.5	5.2	30	40	2.8	100	10	S064
AM83135-030	3100-3500	30	8.5	5.5	30	40	1.5	100	10	S064
AM83135-040	3100-3500	40	12.5	5.1	30	40	1.2	100	10	S064
AM83135-050	3100-3500	50	15	5.2	30	42	0.40	10	10	S064
AM3135-007*	3100-3500	6.5	1.63	6.0	30	30	5.8	500	10	S064
AM3135-014	3100-3500	13.5	3.4	6.0	32	30	3.5	500	10	S064
AM3135-025	3100-3500	25	6.25	6.0	35	30	2.0	500	10	S064
AM3135-25N	3100-3500	25	6.25	6.0	35	30	2.0	500	10	S065
AM3135-035	3100-3500	35	8.8	6.0	35	30	1.5	500	10	S064
AM3135-045*	3100-3500	45	11.3	6.0	35	30	1.2	500	10	S036

\*In development

# SELECTION GUIDE



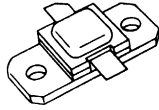
.400 x .400 2LFL  
(S036)



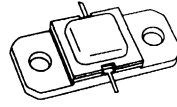
.400 x .400 2NLF  
(S042)

## 1400-2700 MHz CLASS C, COMMON BASE, BROADBAND

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>C</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
AM1416-001	1400-1600	1.5	0.20	8.8	45	24	22	S042
AM1416-003	1400-1600	3.2	0.50	8.1	45	24	15	S042
AM81416-006	1400-1600	5.0	1.0	7.0	45	20	9.0	S042
AM81416-012	1400-1600	11.2	2.0	7.5	47	20	5.5	S036
AM81416-020	1400-1600	17.6	4.0	6.4	45	20	3.0	S036
AM1418-001	1400-1800	1.5	0.20	8.8	45	24	22	S042
AM1418-003	1400-1800	3.0	0.50	7.8	45	24	15	S042
AM1618-001	1600-1800	1.5	0.20	8.8	45	24	22	S042
AM1618-003	1600-1800	3.2	0.50	8.1	45	24	15	S042
AM81618-005	1600-1800	4.6	1.0	6.6	47	20	9.0	S042
AM81618-009	1600-1800	9.0	1.0	9.5	45	24	9.0	S042
AM81618-010	1600-1800	9.5	2.0	6.8	47	20	5.5	S036
AM81618-016	1600-1800	16	3.0	7.3	45	24	3.5	S036
AM81618-020	1600-1800	16	4.0	6.0	45	20	3.0	S036
AM1720-001	1700-2000	1.25	0.25	7.0	45	24	22	S042
AM1720-003	1700-2000	3.0	0.50	7.8	45	24	15	S042
AM1720-006	1700-2000	6.0	1.0	7.8	45	24	9.5	S042
AM81720-012	1700-2000	12	2.2	7.4	40	24	5.5	S036
AM81720-020	1700-2000	20	4.5	6.5	42	24	3.0	S036
AM1821-001	1800-2100	1.25	0.25	7.0	45	24	22	S042
AM1821-003	1800-2100	3.0	0.50	7.8	45	24	15	S042
AM1821-006	1800-2100	6.0	1.0	7.8	45	24	9.5	S042
AM81821-010	1800-2100	10.0	2.2	6.6	40	24	5.5	S036
AM81821-018	1800-2100	18.0	4.5	6.0	40	24	3.0	S036



.400 x .400 2LFL  
(S036)

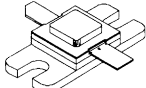


.400 x .400 2NLF  
(S042)

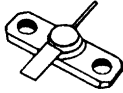
1400-2700 MHz CLASS C, COMMON BASE, BROADBAND (CONT'D)

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>c</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
AM1922-001	1900-2200	1.25	0.25	7.0	40	24	22	S042
AM1922-003	1900-2200	3.0	0.50	7.8	40	24	15	S042
AM1922-006	1900-2200	6.0	1.0	7.8	40	24	9.5	S042
AM81922-010	1900-2200	10.0	2.2	6.6	40	24	5.5	S036
AM81922-018	1900-2200	18.0	4.5	6.0	40	24	3.0	S036
AM2023-001	2000-2300	1.25	0.25	7.0	45	24	22	S042
AM2023-003	2000-2300	3.0	0.50	7.8	50	24	15	S042
AM2023-006	2000-2300	6.0	1.0	7.8	45	24	9.5	S042
AM82023-010	2000-2300	10.0	2.2	6.6	40	24	5.5	S036
AM82023-016	2000-2300	16.0	4.0	6.0	40	24	3.0	S036
AM2327-001	2300-2700	1.0	0.25	6.0	35	24	24	S042
AM2327-003	2300-2700	2.6	0.50	7.2	40	24	15	S042
AM82327-004	2300-2700	4.0	1.0	6.0	30	24	11	S042
AM2327-005	2300-2700	5.0	1.0	7.0	35	24	9.0	S042
AM82327-006	2300-2700	6.0	1.75	5.4	30	24	9.0	S042
AM82327-010	2300-2700	9.0	2.75	5.2	30	24	5.5	S036
AM82327-015	2300-2700	15.0	6.0	4.0	30	24	3.0	S036

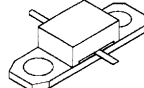
# SELECTION GUIDE



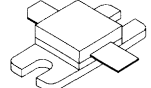
.397 x .397 2LFL  
(M147)



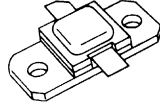
.230 2LFL  
(M151)



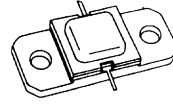
.250 SQ. 2LFL  
(M170)



.400 SQ. 2LFL  
(M186)



.400 x .400 2LFL  
(S036)



.400 x .400 2NLF  
(S042)

## 1500-1700 MHz CLASS C, COMMON BASE, SATCOM APPLICATIONS

PART NO.	FREQ. (GHz)	POUT MIN. (W)	PIN (W)	GAIN MIN (dB)	$\eta_C$ MIN (%)	VCC (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
SD1891-03	1.6-1.7*	5	0.20	14.0	45	28	12	M151
SD1893-03	1.6-1.7*	10	0.80	11.0	40	28	5.5	M151
SD1897	1.6-1.7*	10	0.80	11.0	48	28	6.0	M170
SD1895-03	1.6-1.7*	20	2.4	9.2	48	28	4.0	M170
SD1888-03	1.6-1.7*	24	3.0	9.0	50	28	3.5	M170
SD1868	1.6-1.7*	30	4.0	8.8	40	28	3.0	M147
AM1517-012	1.5-1.7 <sup>(1)</sup>	12	1.7	8.5	55	28	5.5	S042
AM1517-025	1.5-1.7 <sup>(1)</sup>	25	3.5	8.5	55	28	3.3	S042
SD1898	1.6-1.7*	32	4.0	9.0	40	28	2.0	M186
AM1517-035	1.5-1.7 <sup>(1)</sup>	35	7.0	7.0	48	28	2.6	S036
AM1616-050	1.62	50	10.0	7.0	45	26	1.8	S036

\*Test frequency-1.65GHz

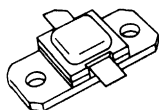
### AM1517 series band segment code(2)

A	1500-1550MHz
M	1620-1660MHz
S	1625-1675MHz

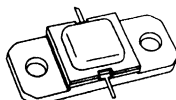
1) AM1517 series vary P<sub>IN</sub> to achieve P<sub>OUT</sub>; performance guaranteed in 50MHz increments

2) Alpha-Suffix added to AM1517 P/N designates band segment .

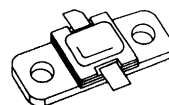




.400 x .400 2LFL  
(S036)



.400 x .400 2NLF  
(S042)

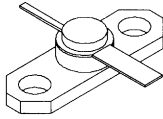


.310 x .310 2LFL  
(S064)

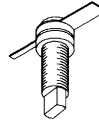
### 1700-2400 MHz CLASS C, COMMON BASE, TELEMETRY/DATA LINK

PART NO.	FREQ. (GHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN. (dB)	η <sub>c</sub> MIN (%)	V <sub>CC</sub> (V)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
AM81719-030	1.75-1.85	20	6.0	6.7	40	28	2.6	S036
AM81719-040	1.75-1.85	40	8.0	7.0	45	28	2.2	S036
AM82022-020	2.0-2.15	20	4.0	7.0	40	22	2.5	S036
AM82223-004	2.2-2.3	1.0	0.70	7.6	45	21	11	S042
AM82223-010	2.2-2.3	9.9	2.0	6.5	40	24	4.4	S042
AM82223-012	2.2-2.3	11	2.2	7.0	40	24	5.5	S036
AM82223-014	2.2-2.3	12	2.1	7.6	45	22	3.9	S064
AM82223-018	2.2-2.3	18	4.0	6.5	40	24	3.0	S036
AM82223-020	2.2-2.3	20	4.0	7.0	40	22	2.7	S064
AM82324-020	2.3-2.4	20	5.0	6.0	40	22	2.5	S036

# SELECTION GUIDE



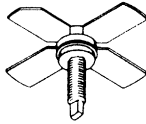
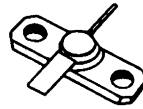
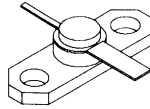
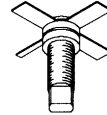
.250 2LFL  
(S010)



230 2L STUD  
(S016)

## 1000-4000 MHz CLASS C, COMMON BASE, GENERAL PURPOSE

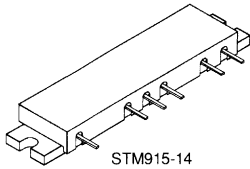
PART NO.	FREQ. (GHz)	P <sub>OUT</sub> MIN. (W)	P <sub>IN</sub> (W)	GAIN MIN (dB)	η <sub>c</sub> MIN (%)	V <sub>CC</sub> (V)	C <sub>OB</sub> MAX (pF)	R <sub>TH(j-c)</sub> MAX (°C/W)	PACKAGE STYLE
MSC81002	1.0	2.0	0.20	10.0	50	28	3.2	20	S016
MSC81118	1.0	2.0	0.20	10.0	50	28	3.2	20	S010
MSC81005	1.0	5.0	0.5	10.0	50	28	6.5	8.0	S016
MSC81111	1.0	5.0	0.5	10.0	50	28	6.5	8.0	S010
MSC81010	1.0	10	1.0	10.0	60	28	10	6.0	S016
MSC81058	1.0	10	1.0	10.0	60	28	10	6.0	S010
MSC81020	1.0	20	2.0	10.0	55	28	19	5.0	S010
MSC81402	1.4	2.0	0.2	10.0	50	28	3.2	25	S010
MSC81406	1.4	6.0	0.65	9.7	45	28	6.0	10	S010
MSC81410	1.4	10	1.4	8.5	45	28	9.5	6.0	S010
MSC82001	2.0	1.0	0.20	7.0	35	28	3.2	20	S010
MSC82003	2.0	3.0	0.50	7.8	35	28	9.5	8.0	S010
MSC82005	2.0	5.0	1.0	7.0	35	28	3.2	6.0	S010
MSC82010	2.0	10	3.16	5.0	35	28	6.5	5.0	S010
MSC82302	2.3	1.8	0.18	10.0	40	22	3.5	25	S010
MSC82304	2.3	3.8	0.38	10.0	40	22	5.0	13	S010
MSC82306	2.3	5.5	0.6	9.6	40	22	7.0	9.0	S010
MSC82307	2.3	7.0	0.76	9.6	40	22	8.5	7.0	S010
MSC3000	3.0	0.5	0.10	7.0	25	28	2.5	45	S010
MSC83301	3.0	1.0	0.20	7.0	33	28	3.5	25	S010
MSC83303	3.0	2.5	0.79	5.0	30	28	5.0	15	S010
MSC83305	3.0	4.5	1.59	4.5	30	28	7.5	8.5	S010
MSC4000	4.0	0.5	0.16	5.0	25	28	2.5	45	S010
MSC4001	4.0	1.0	0.32	5.0	25	28	3.6	25	S010
MSC4003	4.0	2.5	0.79	5.0	25	28	5.0	12.5	S010

.280 4L STUD  
(M122).230 2LFL  
(M151).250 2LFL  
(S011).230 4L STUD  
(S027)

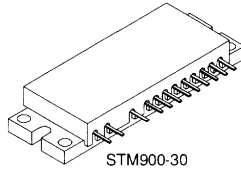
## 1000-4000 MHz CLASS A LINEAR, COMMON EMITTER

PART NO.	FREQ. (GHz)	Power dBm (Watt)	GAIN dB (dB)	BIAS		V <sub>CE</sub> MAX (VDC)	V <sub>CE</sub> MAX (VDC)	V <sub>CE</sub> MAX (VDC)
				V <sub>CE</sub> (V)	I <sub>C</sub> (mA)			
MSC82100	1.0	27	10.5	18	100	20	3.2	S011
MSC82040	1.0	27	10.5	18	100	20	3.2	S027
SD5000	1.0	31.8	9.5	20	220	25	4.0	M122
SD1851	2.0	29	8.0	20	120	30	—	M151
SD1853	2.0	31.8	7.0	20	220	15	—	M151
MSC80064	2.0	20.5	9.0	18	50	45	2.5	S011
MSC80195	2.0	28	7.5	18	140	35	3.0	S011
MSC80185	2.0	28	7.5	18	140	35	3.0	S027
MSC80196	2.0	29	7.0	18	220	17	5.0	S011
MSC80186	2.0	30	7.0	18	220	17	5.0	S027
MSC80197	2.0	31.7	6.0	18	360	8.5	7.0	S011
SD1855	2.0	34	6.0	20	440	8.5	—	M151
SD1850	2.3	28	11.0	15	80	45	—	M151
MSC80264	4.0	20	6.0	12	60	45	2.5	S011

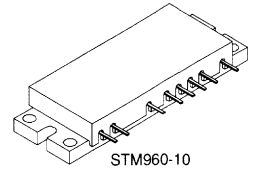
## SELECTION GUIDE



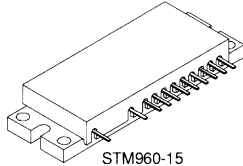
STM915-14



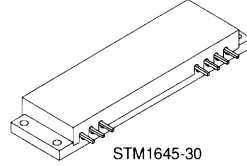
STM900-30



STM960-10



STM960-15



STM1645-30

## HYBRID POWER MODULES

### 800-960 MHz CLASS AB HYBRID POWER MODULES, DIGITAL CELLULAR & GENERAL PURPOSE UHF APPLICATIONS

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	V <sub>CC</sub> (V)	PACKAGE DIMENSIONS (INCHES/MILLIMETERS)
STM915-14	890-915	14	41.5	35	12.5	.550 x 2.39/14.0 x 60.5 (flange)
STM900-30	860-900	30	36	25	26	.925 x 2.60/23.5 x 66.0 (flange)
STM960-10	915-960	10	26	30	26	.925 x 2.60/23.5 x 66.0 (flange)
STM960-15	915-960	15	22	31	26	.925 x 2.60/23.5 x 66.0 (flange)

### 1.6 GHz CLASS C HYBRID POWER MODULES, SATCOM APPLICATIONS

PART NO.	FREQ. (MHz)	P <sub>OUT</sub> MIN. (W)	GAIN MIN (dB)	$\eta_c$ MIN (%)	V <sub>CC</sub> (V)	PACKAGE DIMENSIONS (INCHES/MILLIMETERS)
STM1645-10	1625-1665	10	30	40	28	—
STM1645-30	1625-1665	30	35	40	28	1.0 x 3.78/25.6 x 96.0 (flange)

## RF Products P/N Cross Reference

INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER	INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER
2N3375	SD1050		729	AM1720-6	AM1720-006		30
2N3733	SD1075		741	AM1821-1	AM1821-001		30
2N4440	SD1060		733	AM1821-3	AM1821-003		30
2N5944	SD1144		771	AM1821-6	AM1821-006		30
2N5946	SD1146		775	AM1922-1	AM1922-001		31
2N6080	SD1012		683	AM1922-3	AM1922-003		31
2N6081	SD1014-02		707	AM1922-6	AM1922-006		31
2N6084	SD1018		715	AM2023-1	AM2023-001		189
2N6166	SD1477		993	AM2023-3	AM2023-003		193
2N6439	SD1462		961	AM2023-6	AM2023-006		197
10A015	SD5000		1367	AM2327-1	AM2327-001		201
AM0405-30	AM0405-030		47	AM2327-3	AM2327-003		205
AM0405-100	AM0405-100		51	AM2327-5	AM2327-005		209
AM0608-20	AM0608-020		55	AM2729-110	AM2729-110		213
AM0608-70	AM0608-070		59	AM2729-125	AM2729-125		217
AM0608-200	AM0608-200		63	AM2931-110	AM2931-110		219
AM0608-450	AM0608-450		65	AM2931-125	AM2931-125		223
AM0710-300	AM0710-300		69	AM3135-7	AM3135-007		225
AM0912-50	AM0912-050		26	AM3135-14	AM3135-014		227
AM0912-75	AM80912-085		277	AM3135-25	AM3135-025		229
AM0912-80	AM0912-080		73	AM3135-35	AM3135-035		233
AM0912-120	SD1538-08		1123	AM3135-45	AM3135-045		235
AM0912-200	SD8250		1371	AM80610-18	AM80610-018		241
AM0912-300	AM0912-300		83	AM80610-30	AM80610-030		245
AM0912-350	AM0912-350		89	AM0610-50	AM80610-050		249
AM1011-50	AM1011-050		93	AM80814-5	AM80814-005		253
AM1011-55	AM1011-055		95	AM80814-25	AM80814-025		259
AM1011-60	AM1011-060		97	AM80912-5	AM80912-005		261
AM1011-70	AM1011-070		101	AM80912-15	AM80912-015		265
AM1011-75	AM1011-075		105	AM80912-30	AM80912-030		271
AM1011-175	AM1011-175		109	AM80912-85	AM80912-085		277
AM1011-225	AM1011-225		111	AM81214-6	AM81214-006		281
AM1011-350	AM1011-350		115	AM81214-15	AM81214-015		285
AM1011-400	AM1011-400		119	AM81214-30	AM81214-030		289
AM1011-500	AM1011-500		125	AM81214-60	AM81214-060		295
AM1214-100	AM1214-100		129	AM81416-6	AM81416-006		301
AM1214-200	AM1214-200		137	AM81416-12	AM81416-012		305
AM1214-300	AM1214-300		141	AM81416-20	AM81416-020		309
AM1214-325	AM1214-325		147	AM81618-5	AM81618-005		30
AM1416-3	AM1416-001		151	AM81618-9	AM81618-009		30
AM1416-3	AM1416-003		155	AM81618-10	AM81618-010		30
AM1416-100	AM1416-100		159	AM81618-16	AM81618-016		30
AM1416-200	AM1416-200		163	AM81618-20	AM81618-020		30
AM1418-1	AM1418-001		30	AM81719-30	AM81719-030		313
AM1418-3	AM1418-003		30	AM81719-40	AM81719-040		317
AM1517-12	AM1517-012		167	AM81720-12	AM81720-012		319
AM1517-25	AM1517-025		173	AM81720-20	AM81720-020		323
AM1517-35	AM1517-035		179	AM81821-10	AM81821-010		30
AM1616-50	AM1616-050		185	AM81821-18	AM81821-018		30
AM1618-1	AM1618-001		30	AM81922-10	AM81922-010		31
AM1618-3	AM1618-003		30	AM81922-18	AM81922-018		327
AM1720-1	AM1720-001		30	AM82022-20	AM82022-020		331
AM1720-3	AM1720-003		30	AM82023-10	AM82023-010		333

# RF Products P/N Cross Reference

INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER	INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER
AM82023-16	AM82023-016		337	BLV20	SD1013-03		687
AM82223-4	AM82223-004		341	BLV30	SD1448		921
AM82223-10	AM82223-010		345	BLV33	SD1459		949
AM82223-12	AM82223-012		347	BLV33F	SD1458		945
AM82223-14	AM82223-014		351	BLV36	SD1456		935
AM82223-18	AM82223-018		353	BLV45/12	SD1428		881
AM82223-20	AM82223-020		357	BLV57		SD1732	1253
AM82324-20	AM82324-020		359	BLV58	SD1490		1035
AM82325-40	AM82325-040		361	BLV59	SD4017		1351
AM82327-4	AM82327-004		365	BLV62	SD1492		1041
AM82327-6	AM82327-006		369	BLV75/12	SD1477		993
AM82327-10	AM82327-010		373	BLV80/28	SD1019-05	SD1457	941
AM82327-15	AM82327-015		377	BLV97	SD1495-03		1049
AM82729-30	AM82729-030		381	BLV97CE	SD1425		873
AM82729-60	AM82729-060		385	BLV98	SD1400-02	SD1400-03	821
AM82731-1	AM82731-001		389	BLV98CE	SD1423		863
AM82731-3	AM82731-003		393	BLV100	SD1398		815
AM82731-6	AM82731-006		397	BLV102	SD4590		1357
AM82731-12	AM82731-012		401	BLW29	SD1143		761
AM82731-25	AM82731-025		403	BLW30	SD1274		795
AM82731-50	AM82731-050		407	BLW31	SD1274		795
AM82731-75	AM82731-075		411	BLW32	SD1439		911
AM82931-55	AM82931-055		413	BLW33	SD1449		927
AM83135-1	AM83135-001		431	BLW34	SD1437		907
AM83135-3	AM83135-003		435	BLW40	SD1273	SD1275	803
AM83135-5	AM83135-005		439	BLW60C	SD1018		715
AM83135-10	AM83135-010		443	BLW76	SD1457		941
AM83135-15	AM83135-015		447	BLW77	SD1729	SD1407	835
AM83135-30	AM83135-030		449	BLW78	SD1729	SD1407	835
AM83135-40	AM83135-040		451	BLW79	SD1134	SD1144	771
AM83135-50	AM83135-050		453	BLW80	SD1135		753
B12-12	SD1014-02		707	BLW81	SD1146	SD1143	761
B25-28	SD1224		779	BLW83	SD1224-10		787
B2-8Z	SD1135-03		757	BLW85	SD1018-06		719
B3-12	SD1012		683	BLW86	SD1224-02		783
B5-8Z	SD1146-03		775	BLW89	SD4012	SD1420	849
B70-28	SD1019		723	BLW90	SD1437		907
B8-12	SD1014-02		707	BLW95	SD1726		1209
BAM80	SD1477		993	BLW96	SD1731		1245
BLF177	SD1920		1313	BLW98	SD1448	SD4011	1333
BLF278	SD1920-02		1317	BLW99	SD1487	SD1449	927
BLU10/12	SD1433		895	BLX15	SD1727		1217
BLU11SL		SD1134-05	749	BLX39	SD1224		779
BLU15/12	SD1429-03		891	BLX91A		SD1462	961
BLU20/12	SD1422		857	BLY88C	SD1143		761
BLU30/12	SD1488		1025	BLY88C/01	SD1143		761
BLU45/12	SD1434		901	BLY89C	SD1274		795
BLU60/28	SD1462		961	BLY91C	SD1013		691
BLU97	SD1433		895	BM100-28	SD1480		999
BLU99	SD1135		753	BM45-12	SD1428		881
BLV10	SD1143		761	BM70-12	SD1477		993
BLV11	SD1143-01		767	C2M100-28	SD1470		977
BLV12	SD1274-01		799	C2M100-28A	SD1470		977

## RF Products P/N Cross Reference

INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER	INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER
C2M60-28	SD1462		961	MRAL2023-3H	AM2023-003		193
C2M70-28	SD1462		961	MRAL2023-6H	AM2023-006		197
C3-28	SD1449		927	MRAL2023-1.5H	AM2023-001		189
C5-12	SD1135		753	MRAL2327-1.3	AM2327-001		201
CD3401	SD1458		945	MRAL2327-12H	AM82327-015	AM82327-010	373
CD4205	SD1480		999	MRF10005	SD1512	AM80912-005	261
CEL500	SD1650		1183	MRF1000MB	MSC1000MP		463
CM50-12A	SD1434		901	MRF1002MB	MSC1002MP		473
CM80-28R	SD1470		977	MRF10030	AM80912-030		271
DME10	SD1528-08		1087	MRF1004MB	SD1526-01		1071
DME150	MSC81150M		575	MRF10070	AM1011-075		105
DME2	MSC1002M		467	MRF10120	AM0912-150		77
DME25	MSC81035M		555	MRF10150	AM1011-175		109
DME250	MSC81250M	SD8250	583	MRF1015MB	SD1528-06		1083
DME375	SD1541-01	MSC81450M	613	MRF10350	AM1011-350	AM1011-400	119
DME375A	SD1541-01	MSC81450M	613	MRF1035MB	MSC81035MP	SD1530-01	1091
DME50	SD1534-08		1105	MRF10500	AM1011-500		125
DME75	SD1536-08		1113	MRF1090MB	SD1536-03		1109
DMEG250	SD8250		1371	MRF1150M	SD1538-02	MSC81150M	575
LAE4001R	MSC80264		533	MRF1250M	MSC81250M		583
LCE2009S	MSC80185		503	MRF1325M	MSC81325M	SD1540-08	1135
LEE1015T	SD5000		1367	MRF151	SD1920		1313
LTE21009R	MSC80196	SD1851	1267	MRF151G	SD1920-02		1317
LTE21015R	SD1853	MSC80197	527	MRF212	SD1143		761
LTE21025R	SD1855		1275	MRF216	SD1428		881
MRA0204-30V	SD4013		1245	MRF220	SD1012-03		687
MRA0204-60V	SD1468	SD1462	961	MRF221	SD1014-06		711
MRA0204-70	SD1468	SD1462	961	MRF224	SD1018-06		719
MRA0510-15H	AM80610-018		241	MRF232	SD1143		761
MRA0510-50H	AM80610-050		249	MRF240	SD1275	SD1273	791
MRA0610-18A	AM80610-018		241	MRF247	SD1477		993
MRA0610-18H	AM80610-018		241	MRF315	SD1224-02		783
MRA0610-40A	AM80610-050		249	MRF316	SD1458	SD1019	723
MRA1214-55H	AM81214-060		295	MRF317	SD1480		999
MRA1417-2	AM1418-003		30	MRF325	SD4013		1345
MRA1417-2H	AM1418-003		30	MRF327	SD1470	SD1468	973
MRA1600-2	SD1891		1289	MRF329	SD1470		977
MRA1600-6	SD1891-03		1289	MRF340	SD1013-03		699
MRA1600-13	SD1895	AM1517-012	167	MRF392	SD1463		965
MRA1600-30	SD1898		1309	MRF393	SD1464		969
MRA1600-50H	AM1616-050		185	MRF401	SD1224		779
MRA1618-35H	AM81719-040	AM1517-035	179	MRF406	SD1285		811
MRA1720-2	AM1720-003		30	MRF410	SD1224-10		787
MRA1720-5	AM1720-006		30	MRF421	SD1487		1019
MRA1720-9	AM81720-012		319	MRF422	SD1730	SD1729	1235
MRA1720-20	AM81720-020		323	MRF426	SD1224-10		787
MRAL1417-2	AM1418-003		30	MRF428	SD1726		1209
MRAL1720-2	AM1720-003		30	MRF429	SD1726		1209
MRAL1720-5	AM1720-006		30	MRF433	SD1285		811
MRAL1720-9	AM81720-010		319	MRF448	SD1731	SD1728	1225
MRAL1720-20	AM81720-020		323	MRF454	SD1405		831
MRAL2023-12H	AM82023-010		333	MRF455	SD1446		775
MRAL2023-18H	AM82023-016		337	MRF641	SD1429-03		891

## RF Products P/N Cross Reference

INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER	INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER
MRF644	SD1422		857	MSC1175M	MSC81175M		579
MRF646	SD1434	SD1488	1025	MSC1250M	MSC81250M		583
MRF650	SD1434		901	MSC1300M	MSC81300M	SD1540-08	1135
MRF652	SD1433	SD1135	753	MSC1325M	MSC81325M	SD1540-08	1135
MRF652	SD1135-03		759	MSC1350M	MSC81350M		595
MRF653	SD1433		895	MSC1400M	MSC81400M	SD1541-01	1141
MRF750	SD1134-05		749	MSC1450M	MSC81450M	SD1541-09	1147
MRF846	SD1414		843	MSC1550M	MSC81550M	SD1542	1151
MRF847	SD1414		843	MSC1600M	MSC81600M	SD1542-04	1155
MRF880	SD1680		1201	MSC2001	MSC82001		627
MRF890S	SD1420-01		853	MSC2003	MSC82003		631
MRF892	SD1400-02		821	MSC2005	MSC82005		635
	SD1400-03		827	MSC2010	MSC82010		639
MRF894	SD1495-03		1049	MSC2100	MSC82100		649
MRF898	SD1426		877	MSC2302	MSC82302		655
MRF899	SD4590		1357	MSC2304	MSC82304		659
MRF1946	SD1275		803	MSC2307	MSC82307		667
MRF1946A	SD1275-01		807	MSC3000	MSC3000		479
MRF2628	SD1146		775	MSC3001	MSC83301		671
MRF5174	SD1420	SD1449	927	MSC3003	MSC83303		675
MRF5175	SD1437		907	MSC3005	MSC83305		679
MRW2001	MSC82001		627	MSC4000	MSC4000		485
MRW2003	MSC82003		631	MSC4001	MSC4001		489
MRW2005	MSC82005		635	MSC4003	MSC4003		493
MRW2010	MSC82010		639	MSC80040	MSC82040		643
MRW2301	MSC82302		655	MSC80058	MSC81058		563
MRW2304	MSC82304		659	MSC80064	MSC80064		497
MRW2307	MSC82307		667	MSC80111	MSC81111		567
MRW3001	MSC83301		671	MSC80118	MSC81118		571
MRW3003	MSC83303		675	MSC80185	MSC80185		503
MRW3005	MSC83305		679	MSC80186	MSC80186		509
MRW52501	MSC80186		509	MSC80195	MSC80195		515
MRW52601	MSC80196	SD1853	1271	MSC80196	MSC80196		521
MSC1000M	MSC1000M		457	MSC80197	MSC80197		527
MSC1000MP	MSC1000MP		461	MSC80264	MSC80264		533
MSC1002	MSC81002		539	MSC81002	MSC81002		539
MSC1002M	MSC1002M		465	MSC81005	MSC81005		543
MSC1002MP	MSC1002MP		471	MSC81010	MSC81010		547
MSC1004M	SD1526-08		1075	MSC81020	MSC81020		551
MSC1004MP	SD1526-01		1071	MSC81035M	MSC81035M		557
MSC1004MS	SD1526		1071	MSC81035MP	MSC81035MP		559
MSC1005	MSC81005		543	MSC81058	MSC81058		563
MSC1010	MSC81010		547	MSC81111	MSC81111		567
MSC1015M	SD1528-08		1087	MSC81118	MSC81118		571
MSC1015MP	SD1528-06		1083	MSC81150M	MSC81150M		575
MSC1020	MSC81020		551	MSC81175M	MSC81175M		579
MSC1035M	MSC81035M		555	MSC81250M	MSC81250M		583
MSC1035MP	MSC81035MP		559	MSC81300M	MSC81300M		587
MSC1075M	SD1534-08		1105	MSC81325M	MSC81325M		591
MSC1075MP	SD1534-01		1101	MSC81350M	MSC81350M		595
MSC1090M	SD1536-08		1113	MSC81390M	MSC81390M		599
MSC1090MP	SD1536-03		1109	MSC81400M	MSC81400M		603
MSC1150M	MSC81150M	SD1538-08	1123	MSC81402	MSC81402		607



## RF Products P/N Cross Reference

INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER	INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER
MSC81406	MSC81406		609	PH3134-55L	AM3135-045		235
MSC81410	MSC81410		611	PH3135-5S	AM83135-005		439
MSC81450M	MSC81450M		613	PH3135-25S	AM83135-030		449
MSC81550M	MSC81550M		617	PH3135-5M	AM83135-005		439
MSC81600M	MSC81600M		621	PH3135-20M	AM83135-015		447
MSC82001	MSC82001		627	PH3135-65M	AM83135-050		453
MSC82003	MSC82003		631	PLB16030U	SD1898		1309
MSC82005	MSC82005		635	PTB23001X	MSC82001		627
MSC82010	MSC82010		639	PTB23003X	MSC82003		631
MSC82040	MSC82040		643	PTB23005X	MSC82005		635
MSC82100	MSC82100		649	PTB32001X	MSC83301		671
MSC82302	MSC82302		655	PTB32003X	MSC83303		675
MSC82304	MSC82304		659	PTB32005X	MSC83305		679
MSC82306	MSC82306		663	PTB42001X	MSC4001		489
MSC82307	MSC82307		667	PTB42003X	MSC4003		493
MSC83001	MSC83301		671	PZB16035U	AM1517-035	SD1898	1309
MSC83003	MSC83303		675	PZB16050U	AM1616-050		185
MSC83005	MSC83305		679	PZ1721B12U	AM81720-012		319
MSC83301	MSC83301		671	PZ1721B25U	AM81720-020		323
MSC83303	MSC83303		675	PZ2024B10U	AM82023-010		333
MSC83305	MSC83305		679	PZ2024B20U	AM82023-016	AM82022-020	331
MX0912B250Y	AM0912-300	SD8250	1371	PZ2327B15U	AM82327-015		377
MX0912B350Y	AM0912-350		89	RV3135B5X	AM83135-005		439
MX1011B400W	AM1011-400		119	RX1214B130Y	AM1214-100		129
MZ0912B50Y	AM0912-080		71	RX1214B170Y	AM1214-175		131
MZ0912B100Y	SD1538-08		1123	RX1214B150W	AM1214-200	AM1214-175	131
PH0404-30	AM0405-030		47	RX1214B300Y	AM1214-300		141
HPPH0404-100	AM0405-100		51	RX1214B350Y	AM1214-325		147
PH1090-175L	AM1011-225		111	RX2731B90W	AM82731-075		411
PH1090-350L	AM1011-350		115	RX3034B70W	AM83135-050		453
PH1090-550S	SD1542-04	MSC81600M	621	RXB12350Y	AM1011-350		115
PH1214-4M	AM81214-006		27	RZ1214B35Y	AM81214-030		289
PH1214-25M	AM81214-030		289	RZ1214B65Y	AM81214-060		295
PH1214-40M	AM81214-060		295	RZ2731B16W	AM82731-012		401
PH1214-220M	AM1214-200		137	RZ2731B32W	AM82731-025		403
PH1600-7.5	SD1897		1305	RZ2731B48W	AM82731-050		407
PH1600-14	SD1895		1301	RZ2731B60W	AM82731-075		411
PH1600-30	SD1898		1309	RZ3135B14W	AM83135-015		447
PH2729-5M	AM82731-006		397	RZ3135B28W	AM83135-030		449
PH2729-25M	AM82729-030		381	RZ3135B42W	AM83135-040		451
PH2729-65M	AM82729-060		385	RZ3135B50W	AM83135-050		453
PH2729-110M	AM2729-110		213	RZB12050Y	AM1011-050		93
PH2731-5M	AM82731-006		397	RZB12100Y	AM1011-060		97
PH2731-20M	AM82731-025		403	RZB12250Y	AM1011-225		111
PH2731-80M	AM82731-075		411	S100-12	SD1487		1019
PH2931-135S	AM2931-125		217	S100-28	SD1407		835
PH3134-11S	AM83135-010		443	S100-50	SD1726		1209
PH3134-30S	AM83135-030		449	S15-12	SD1285		811
PH3134-10M	AM83135-010		443	S175-28	SD1730		1239
PH3134-25M	AM83135-030		449	S175-50	SD1726		1209
PH3134-65M	AM83135-050		453	S200-50	SD1731		1245
PH3134-9L	AM3135-007		225	S30-28	SD1224-10		787
PH3134-20L	AM3135-014		227	S70-12	SD1405		831

## RF Products P/N Cross Reference

INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER	INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER
S80-12	SD1405		831	SD1446	SD1446		915
SCELL500	SD1650		1183	SD1448	SD1448		921
SD1012	SD1012		683	SD1449	SD1449		927
SD1012-03	SD1012-03		687	SD1455	SD1455		931
SD1013	SD1013		691	SD1456	SD1456		935
SD1013-03	SD1013-03		699	SD1457	SD1457		941
SD1014-02	SD1014-02		707	SD1458	SD1458		945
SD1014-06	SD1014-06		711	SD1459	SD1459		949
SD1018	SD1018		715	SD1460	SD1460		955
SD1018-06	SD1018-06		719	SD1462	SD1462		961
SD1019	SD1019		723	SD1463	SD1463		965
SD1019-05	SD1019-05		723	SD1464	SD1464		969
SD1050	SD1050		729	SD1468	SD1468		973
SD1060	SD1060		733	SD1470	SD1470		977
SD1070	SD1070		737	SD1474	SD1474		981
SD1075	SD1075		741	SD1476	SD1476		985
SD1134	SD1134		745	SD1477	SD1477		993
SD1134-05	SD1134-05		749	SD1480	SD1480		999
SD1135	SD1135		753	SD1483	SD1483		1005
SD1143	SD1143		761	SD1485	SD1485		1011
SD1143-01	SD1143-01		767	SD1487	SD1487		1019
SD1144	SD1144		771	SD1488	SD1488		1025
SD1146	SD1146		775	SD1489	SD1489		1029
SD1146-03	SD1146-03		775	SD1490	SD1490		1035
SD1224	SD1224		779	SD1492	SD1492		1041
SD1224-02	SD1224-02		783	SD1495-03	SD1495-03		1049
SD1224-10	SD1224-10		783	SD1496	SD1496		1053
SD1273	SD1273		791	SD1496-03	SD1496-03		1057
SD1274	SD1274		795	SD1511-08	SD1511-08		1061
SD1274-01	SD1274-01		799	SD1512	SD1512		1065
SD1275	SD1275		803	SD1526-01	SD1526-01		1071
SD1285	SD1285		811	SD1526-08	SD1526-08		1075
SD1398	SD1398		815	SD1527-08	SD1527-08		1079
SD1400-02	SD1400-02		821	SD1528-06	SD1528-06		1083
SD1400-03	SD1400-03		827	SD1528-08	SD1528-08		1087
SD1405	SD1405		831	SD1530-01	SD1530-01		1091
SD1407	SD1407		835	SD1530-08	SD1530-08		1095
SD1411	SD1411		839	SD1534-01	SD1534-01		1101
SD1414	SD1414		843	SD1534-08	SD1534-08		1105
SD1420	SD1420		849	SD1536-03	SD1536-03		1109
SD1420-01	SD1420-01		853	SD1536-08	SD1536-08		1113
SD1422	SD1422		857	SD1538-02	SD1538-02		1117
SD1423	SD1423		863	SD1538-08	SD1538-08		1123
SD1424	SD1424		867	SD1540	SD1540		1129
SD1425	SD1425		873	SD1540-08	SD1540-08		1135
SD1426	SD1426		877	SD1541-01	SD1541-01		1141
SD1428	SD1428		881	SD1541-09	SD1541-09		1147
SD1429	SD1429		887	SD1542	SD1542		1151
SD1429-03	SD1429-03		891	SD1542-04	SD1542-04		1155
SD1433	SD1433		895	SD1550	SD1550		1161
SD1434	SD1434		901	SD1563	SD1563		1165
SD1437	SD1437		907	SD1564	SD1564		1173
SD1439	SD1439		911	SD1565	SD1565		1177

## RF Products P/N Cross Reference

INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER	INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER
SD1650	SD1650		1183	TCC2023-6	AM2023-006		197
SD1658	SD1658		1189	TCC2023-16	AM82023-016		337
SD1660	SD1660		1195	TCC20L08	SD1851		1267
SD1680	SD1680		1201	TCC20L15	SD1853		1271
SD1726	SD1726		1209	TCC20L25	SD1855		1275
SD1727	SD1727		1217	TCC593	SD1437		907
SD1728	SD1728		1225	TCC596	SD1439		911
SD1729	SD1729		1235	TCC597	SD1449		927
SD1730	SD1730		1239	TCC598	SD1448		921
SD1731	SD1731		1245	TCC2100	MSC82100		649
SD1732	SD1732		1253	TCC2223-3	AM82223-004		341
SD1733	SD1733		1259	TCC2223-10	AM82223-010		345
SD1850	SD1850		1263	TCC2223-18	AM82223-018		353
SD1851	SD1851		1267	TCC2301	MSC82302		655
SD1853	SD1853		1271	TCC2302	MSC82302		655
SD1855	SD1855		1275	TCC2304	MSC82304		659
SD1868	SD1868		1279	TCC2307	MSC82307		667
SD1888-03	SD1888-03		1285	TCC3000	MSC3000		479
SD1891	SD1891-03		1289	TCC3001	MSC83301		671
SD1891-03	SD1891-03		1289	TCC3003	MSC83303		675
SD1893	SD1893-03		1295	TCC3005	MSC83305		679
SD1893-03	SD1893-03		1295	TCC3100	SD1456		935
SD1895	SD1895-03		1301	TDS595	SD1732		1253
SD1895-03	SD1895-03		1301	TH416	SD1729		1235
SD1897	SD1897		1305	TH430	SD1728		1225
SD1898	SD1898		1309	TH513	SD1733		1259
SD1920	SD1920		1313	TH560	SD1730		1239
SD1920-02	SD1920-02		1317	TH562	SD1731		1245
SD1930	SD1930		1321	THA15	SD1726		1209
SD4010	SD4010		1327	THX15	SD1727		1217
SD4011	SD4011		1333	TP2033	SD1274		795
SD4012	SD4012		1339	TP2037	SD1275		803
SD4013	SD4013		1345	TP2317	SD1274		795
SD4017	SD4017		1351	TP2330	SD1274		795
SD4600	SD4600		1363	TP2330F	SD1274-01		799
SD5000	SD5000		1367	TP2335	SD1274		795
SD8250	SD8250		1371	TP3004	SD1398		815
SUMIL3	SD4012		1339	TP3006	SD1398		815
SUMIL25	SD4013		1345	TP3008	SD1398		815
SUTV040	SD4011		1333	TP3019	SD1420		849
SUTV200	SD4010		1327	TP3020A	SD1420		849
TAN250A	SD8250		1371	TP3021	SD1423		863
TCC0105-100	SD1464		969	TP3022A/B	SD1423		863
TCC0204-125	SD1463		965	TP3024A/B	SD1424		967
TCC1720-3	AM1720-003		30	TP3030	SD1425	SD4017	1351
TCC1720-006	AM1720-006		30	TP3031	SD1425	SD4017	1351
TCC1720-10	AM81720-012		319	TP3033	SD1425		873
TCC1720-20	AM81720-020		323	TP3060	SD1650		1183
TCC1922-18	AM81922-018		327	TP3061	SD4701		21
TCC2001	MSC82001		627	TP3062	SD4600		1363
TCC2003	MSC82003		631	TP3064	SD4701	SD1650	1183
TCC2005	MSC82005		635	TP3065	SD1650		1183
TCC2010	MSC82010		639	TP3069	SD4590		1357

## RF Products P/N Cross Reference

INDUSTRY PART NUMBER	SGS-THOMSON NEAREST EQUIVALENT	SGS-THOMSON ALTERNATE REPLACEMENT	PAGE NUMBER
TP5050	SD1462	SD1468	973
TP9380	SD1457		941
TP9383	SD1460		955
TP9386	SD1480		999
TPM401	SD1439	SD1420	849
TPM405	SD1449	SD1420	849
TPM425	SD1448	SD4011	1333
TPM4100	SD1463		965
TPV375	SD1455		931
TPV376	SD1459		949
TPV385	SD1458		945
TPV593	SD1437		907
TPV595A	SD1732		1253
TPV596A	SD1439	SD5000	1367
TPV597	SD1449		927
TPV598	SD1448	SD4011	1333
TPV3100	SD1456		935
TPV5055B	SD1489		1029
TPV7025	SD1490		1035
TPV8200B	SD1492		1041
UMIL3	SD4012		1339
UMIL25	SD4013		1345
UMIL60	SD1462		961
UMIL70	SD1462		961
UMIL100	SD1470		977
UMIL5FT	SD1930		1321
UMOB10	SD1429		887
UMOB20	SD1422		857
UMOB45	SD1488	SD1434	901
UTV010	SD1449		927
UTV020	SD1437		907
UTV040	SD4011		1333
UTV200	SD4010		1327
VAM120	SD1019-05		723
VMIL100	SD1480		999
VMOB30	SD1428		881
VTV150	SD1458		945
VTV1250	SD1456		935

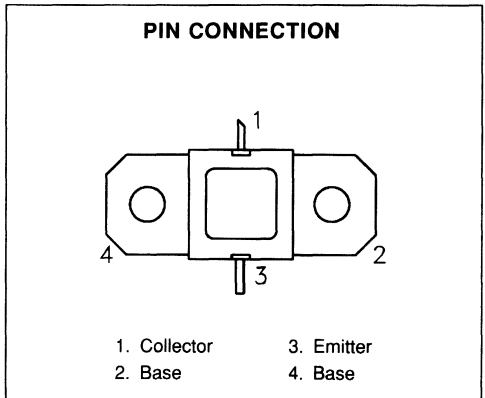
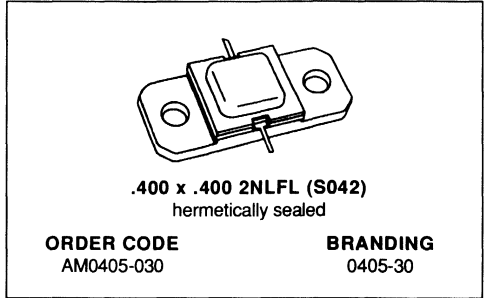
# **DATASHEETS**



**RF & MICROWAVE TRANSISTORS  
UHF PULSE APPLICATIONS**

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- COMMON BASE CONFIGURATION
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 30$  W MIN. WITH 9.3 dB GAIN


**DESCRIPTION**

The AM0405-030 is a gold metallized silicon NPN pulse power transistor using overlay geometry.

The AM0405-030 is designed for pulsed applications in the frequency range of 420 - 450 MHz.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}\text{C}$ )	45	W
$I_C$	Device Current*	2.3	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	4.0	$^{\circ}\text{C}/\text{W}$
---------------	-----------------------------------	-----	-----------------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 15mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CER}$	$I_C = 10mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 32V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 0.1A$	20	—	200	—

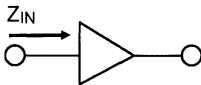
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 420 \text{ — } 450MHz$	$P_{IN} = 3.5W$	$V_{CC} = 32V$	30	—	—	W
$\eta_C$	$f = 420 \text{ — } 450MHz$	$P_{IN} = 3.5W$	$V_{CC} = 32V$	60	—	—	%
$G_P$	$f = 420 \text{ — } 450MHz$	$P_{IN} = 3.5W$	$V_{CC} = 32V$	9.3	—	—	dB

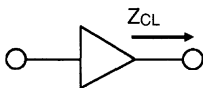
Note: Pulse Width = 10,000 $\mu$ Sec  
 Duty Cycle = 10%

**IMPEDANCE DATA**

**TYPICAL INPUT IMPEDANCE**



**TYPICAL COLLECTOR LOAD IMPEDANCE**

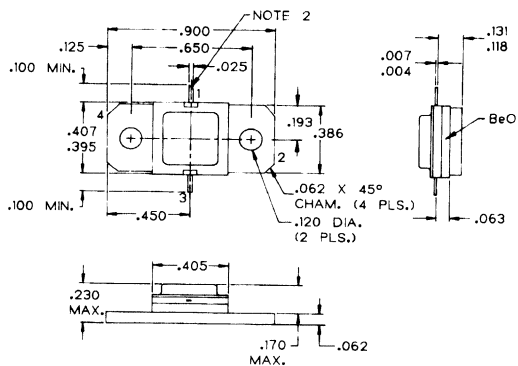


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 420 GHz	$4.7 + j 5.2$	$6.0 + j 6.1$
M = 435 GHz	$4.7 + j 5.2$	$5.6 + j 5.6$
H = 450 GHz	$4.7 + j 5.2$	$5.0 + j 5.2$



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

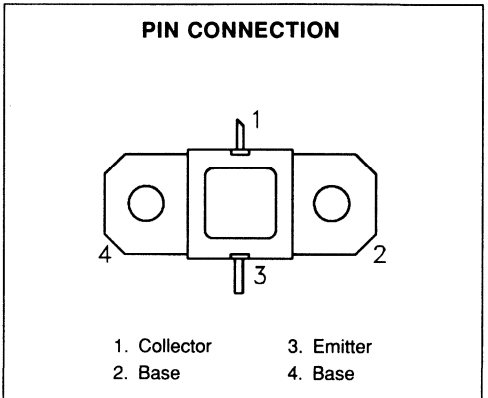
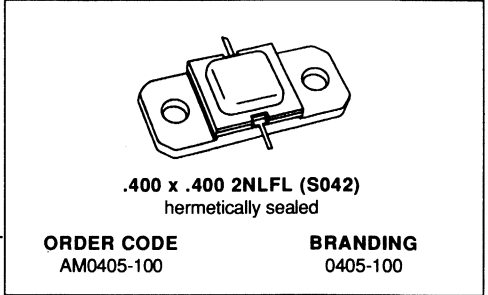
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



## RF & MICROWAVE TRANSISTORS UHF PULSE APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- COMMON BASE CONFIGURATION
- INPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 100$  W MIN. WITH 8 dB GAIN



### DESCRIPTION

The AM0405-100 is a gold metallized silicon NPN pulse power transistor using overlay geometry. The AM0405-100 is designed for pulsed applications in the frequency range of 420-450 MHz.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	120	W
$I_C$	Device Current*	6.9	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 40mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	3.0	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 80mA	V <sub>BE</sub> = 0V	65	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 32V	—	—	15	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 0.5A	20	—	200	—

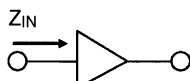
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 420 — 450MHz	P <sub>IN</sub> = 16W	V <sub>CC</sub> = 32V	100	—	—	W
η <sub>c</sub>	f = 420 — 450MHz	P <sub>IN</sub> = 16W	V <sub>CC</sub> = 32V	60	—	—	%
GP	f = 420 — 450MHz	P <sub>IN</sub> = 16W	V <sub>CC</sub> = 32V	7.9	—	—	dB

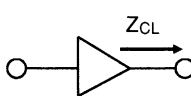
Note: Pulse Width = 10,000µSec  
 Duty Cycle = 20%

IMPEDANCE DATA

**TYPICAL INPUT IMPEDANCE**



**TYPICAL COLLECTOR LOAD IMPEDANCE**

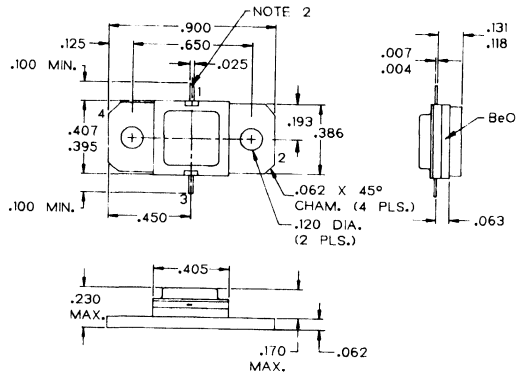


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 420 GHz	3.8 + j 2.2	4.1 - j 1.3
M = 435 GHz	3.8 + j 1.3	3.8 - j 0.9
H = 450 GHz	3.8 + j 0.4	3.5 - j 0.4

P<sub>IN</sub> = 16W  
 V<sub>CC</sub> = 32V  
 Normalized to 50 ohms

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



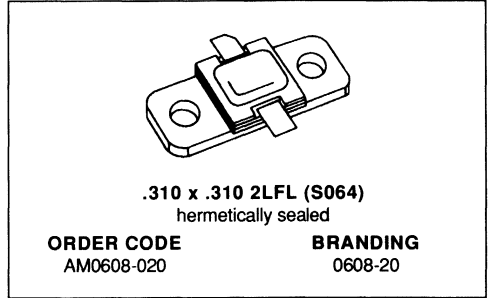
- NOTES:
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
  2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

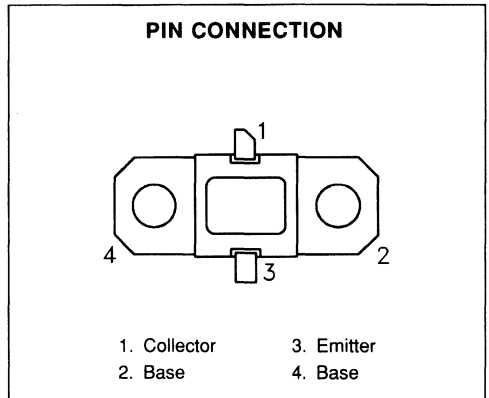
PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 20$  W MIN. WITH 9.0 dB GAIN


**DESCRIPTION**

The AM0608-020 is an internally-matched, common base silicon bipolar device optimized for pulsed applications in the 600 - 7500 MHz frequency range.

Housed in the popular IMPAC™ hermetic metal/ceramic package, this device uses a refractory/gold overlay die geometry for ruggedness and long-term reliability.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	100	W
$I_C$	Device Current*	2.4	A
$V_{CC}$	Collector-Supply Voltage*	40	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 15mA$	$I_E = 0mA$		55	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$		3.5	—	—	V
$BV_{CER}$	$I_C = 15mA$	$R_{BE} = 10\Omega$		55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 35V$		—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 750mA$		20	—	—	—

**DYNAMIC**

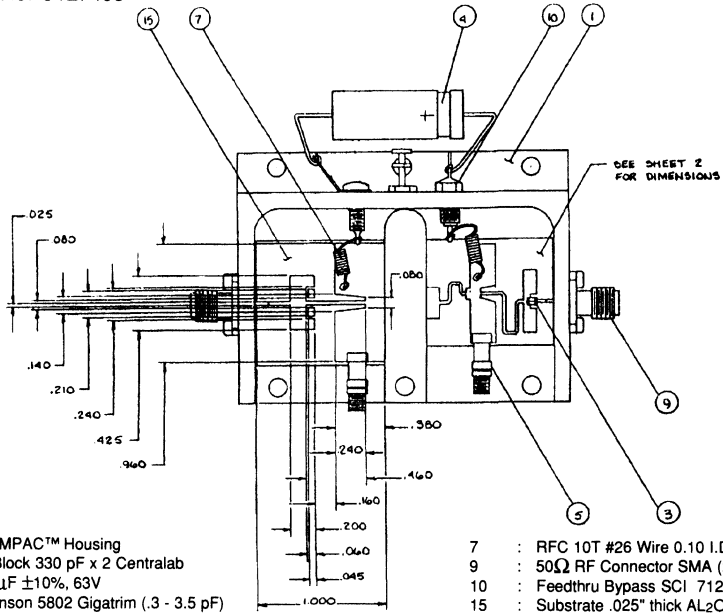
Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{OUT}$	$f = 600 \text{ — } 750 \text{ MHz}$	$P_{IN} = 2.5W$	$V_{CC} = 35V$		20	—	—	W
$\eta_C$	$f = 600 \text{ — } 750 \text{ MHz}$	$P_{IN} = 2.5W$	$V_{CC} = 35V$		40	—	—	%
$G_P$	$f = 600 \text{ — } 750 \text{ MHz}$	$P_{IN} = 2.5W$	$V_{CC} = 35V$		9.0	—	—	dB

Note: Pulse Width =  $10\mu\text{Sec}$   
 Duty Cycle = 10%

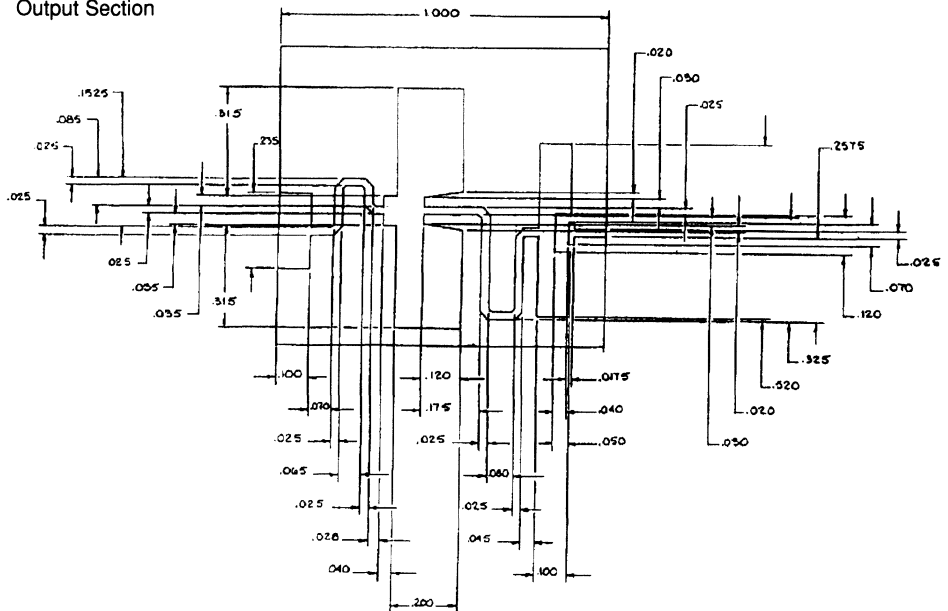


TEST CIRCUIT

Ref.: Dwg. No. C127405

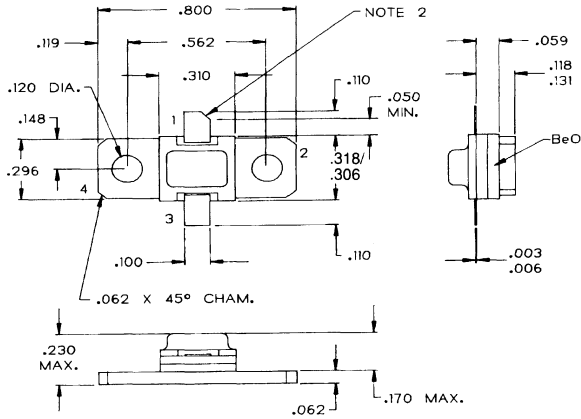


Output Section



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133100D

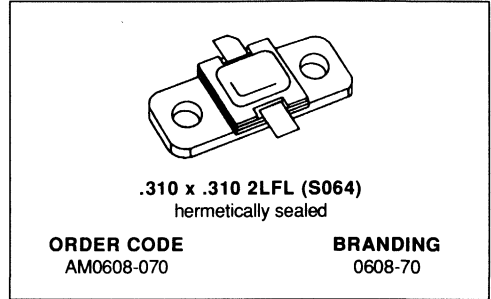


- NOTES:
- 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
  - 2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

PRELIMINARY DATA

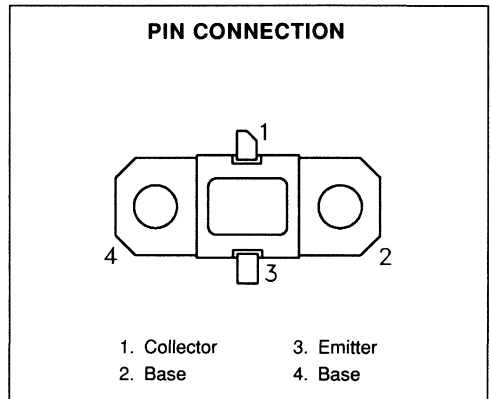
- REFRACTORY/GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 70$  W MIN. WITH 7.3 dB GAIN



### DESCRIPTION

The AM0608-070 is an internally-matched, common base silicon bipolar device optimized for pulsed applications in the 600 - 750 MHz frequency range.

Housed in the popular IMPAC™ hermetic metal/ceramic package, this device uses a refractory/gold overlay die geometry for ruggedness and long-term reliability.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	250	W
$I_C$	Device Current*	6.5	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.60	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

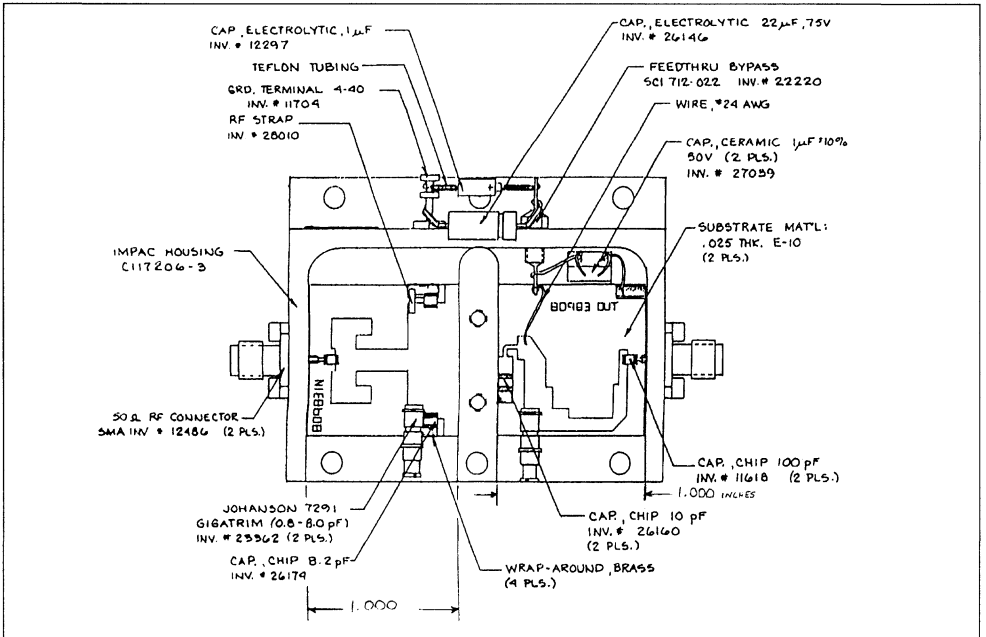
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 10mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 10mA	R <sub>BE</sub> = 10Ω	65	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 50V	—	—	6.25	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500mA	15	—	120	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 600 — 750 MHz	P <sub>IN</sub> = 13W	V <sub>CC</sub> = 50V	70	—	—	W
η <sub>C</sub>	f = 600 — 750 MHz	P <sub>IN</sub> = 13W	V <sub>CC</sub> = 50V	35	—	—	%
G <sub>p</sub>	f = 600 — 750 MHz	P <sub>IN</sub> = 13W	V <sub>CC</sub> = 50V	7.3	—	—	dB

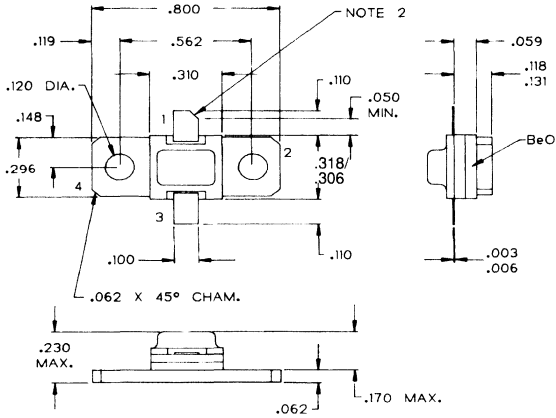
Note: Pulse Width = 10μSec  
Duty Cycle = 1%

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133100D

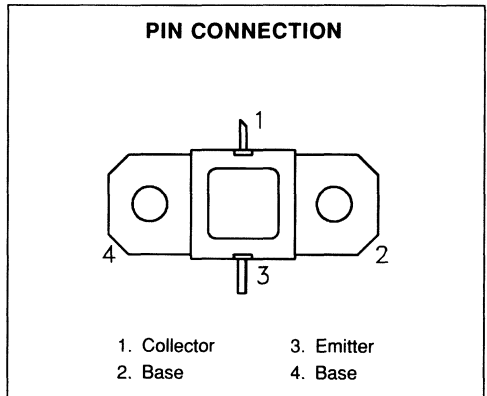
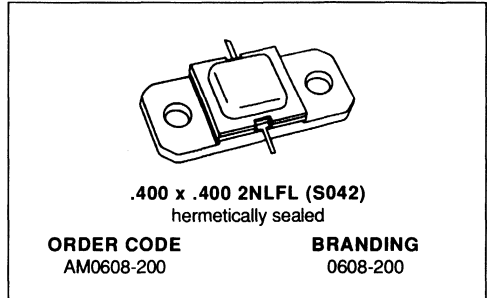




**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 220$  W MIN. WITH 8.7 dB GAIN


**DESCRIPTION**

The AM0608-200 is an internally-matched, common base silicon bipolar device optimized pulsed application in the 600 - 750 MHz frequency range. Housed in the industry-standard AMPAC™ metal/ceramic package, this device uses a refractory/gold overlay die geometry for ruggedness and long-term reliability.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 75^{\circ}C$ )	875	W
$I_C$	Device Current*	16.0	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.20	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

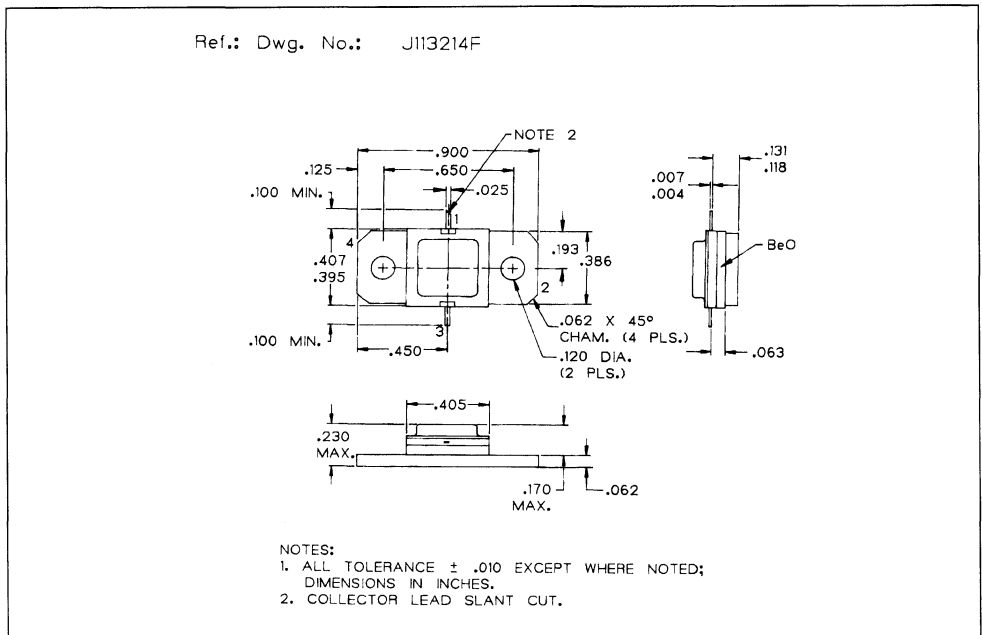
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 50V$	—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1mA$	15	—	120	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 600 - 750MHz$	$P_{IN} = 30W$	$V_{CC} = 50V$	220	—	—	W
$\eta_c$	$f = 600 - 750MHz$	$P_{IN} = 30W$	$V_{CC} = 50V$	40	—	—	%
GP	$f = 600 - 750MHz$	$P_{IN} = 30W$	$V_{CC} = 50V$	8.7	—	—	dB

Note: Pulse Width =  $10\mu Sec$   
 Duty Cycle = 1%

**PACKAGE MECHANICAL DATA**

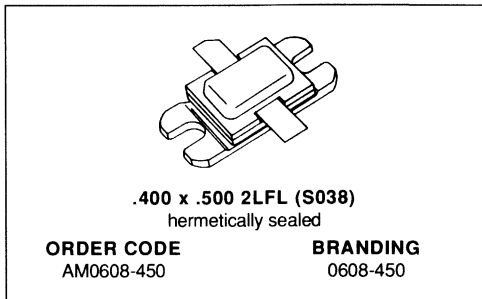




**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

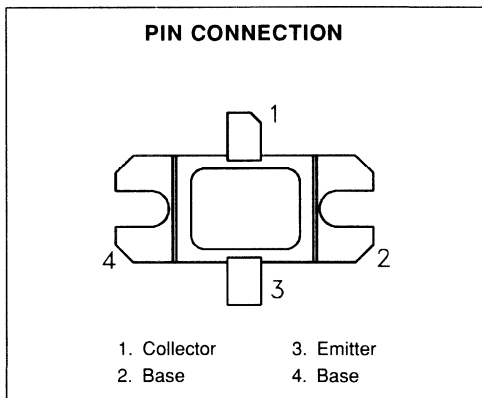
PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- INPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 445$  W MIN. WITH 6.9 dB GAIN


**DESCRIPTION**

The AM0608-450 is an internally-matched, common base silicon bipolar device optimized pulsed application in the 600 - 750 MHz frequency range.

Housed in the industry-standard BIGPAC™ metal/ceramic package, this device uses a refractory/gold overlay die geometry for ruggedness and long-term reliability.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	1500	W
$I_c$	Device Current*	32	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.13	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 50mA	R <sub>BE</sub> = 10Ω	65	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 50V		—	—	35	mA
I <sub>CBO</sub>	V <sub>CB</sub> = 50V		—	—	25	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	15	—	300	—

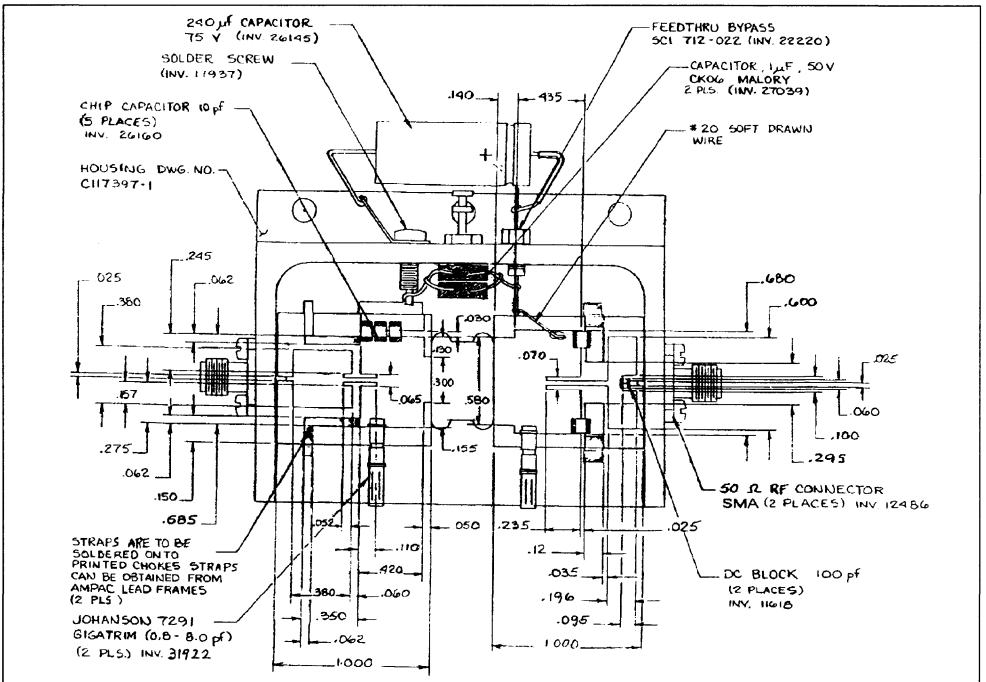
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 600 — 750MHz	P <sub>IN</sub> = 90W	V <sub>CC</sub> = 50V	445	—	—	W
η <sub>C</sub>	f = 600 — 750MHz	P <sub>IN</sub> = 90W	V <sub>CC</sub> = 50V	35	—	—	%
G <sub>P</sub>	f = 600 — 750MHz	P <sub>IN</sub> = 90W	V <sub>CC</sub> = 50V	6.9	—	—	dB

Note: Pulse Width = 10μS

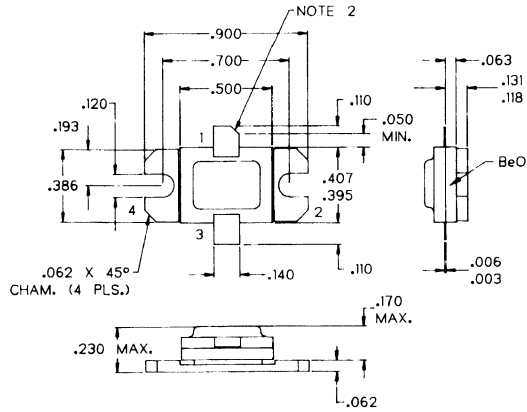
Duty Cycle = 1%

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F



## NOTES:

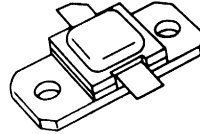
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



## RF & MICROWAVE TRANSISTORS UHF PULSED APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 300 W MIN. WITH 8.8 dB GAIN



**.400 x .400 2LFL (S036)**  
hermetically sealed

**ORDER CODE**  
AM0710-300

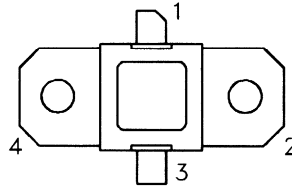
**BRANDING**  
0710-300

### DESCRIPTION

The AM0710-300 is a high power, refractory/gold metallized silicon bipolar device suitable for UHF avionics, radar and EW applications.

With 8.8 dB minimum power gain, the hermetically packaged AM0710-300 is ideal for use in either single-ended or parallel-combined pulsed power amplifiers.

### PIN CONNECTION



- 1. Collector
- 2. Base
- 3. Emitter
- 4. Base

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 100°C)	680	W
I <sub>c</sub>	Device Current*	20	A
V <sub>CC</sub>	Collector-Supply Voltage*	50	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.22	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

# AM0710-300

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 40mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CES}$	$I_C = 40mA$	$V_{BE} = 0V$	65	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 50V$	—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 4mA$	10	—	999	—

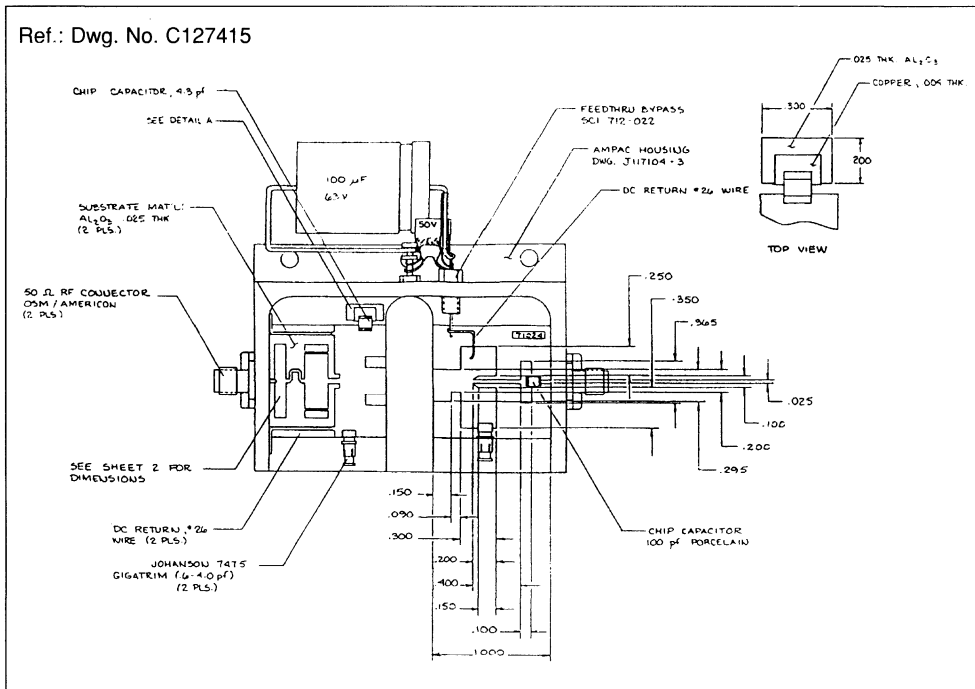
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 750 - 950$ MHz	$P_{IN} = 40W$	$V_{CC} = 50V$	300	—	—	W
$\eta_c$	$f = 750 - 950$ MHz	$P_{IN} = 40W$	$V_{CC} = 50V$	40	—	—	%
$G_p$	$f = 750 - 950$ MHz	$P_{IN} = 40W$	$V_{CC} = 50V$	8.8	—	—	dB

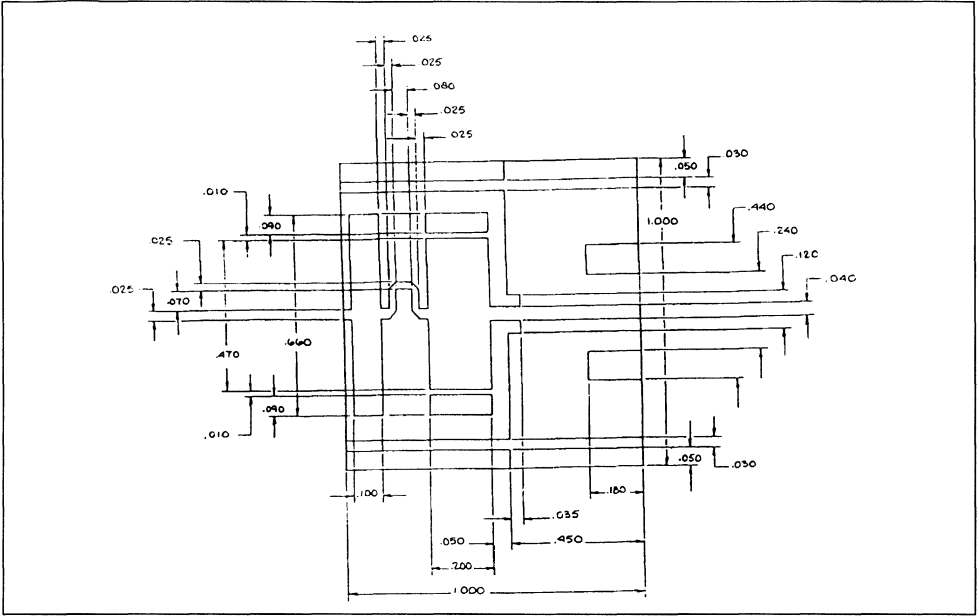
Note: Pulse Width =  $10\mu Sec$

Duty Cycle = 10%

### TEST CIRCUIT

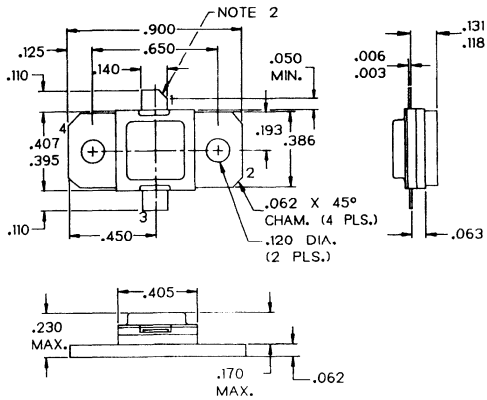


TEST CIRCUIT (cont'd)



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



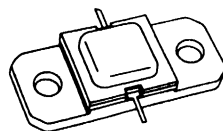
- NOTES:
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
  2. COLLECTOR LEAD CHAMFER  $45^\circ$  NOM. X  $.040$  NOM.





**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 90$  W MIN. WITH 13 dB GAIN
- BANDWIDTH 225 MHz



**.400 x .400 2NLFL (S042)**  
 hermetically sealed

**ORDER CODE**  
 AM0912-080

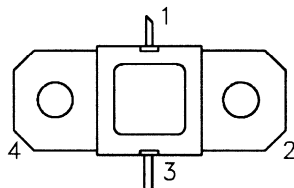
**BRANDING**  
 0912-80

**DESCRIPTION**

The AM0912-080 Avionics power transistor is a broadband, high peak pulse power device specifically designed for avionics applications requiring broad bandwidth with moderate duty cycle and pulse width constraints such as ground/ship based DME/TACAN.

This device is also designed for specialized applications including JTIDS where reduced power provided under pulse formats utilizing short pulse widths and high burst or overall duty cycles.

The AM0912-080 is housed in the unique AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	220	W
$I_C$	Device Current*	7.0	A
$V_{CC}$	Collector-Supply Voltage*	50	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.80	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CB0</sub>	I <sub>C</sub> = 40mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	3.0	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 40mA	R <sub>BE</sub> = 10Ω	65	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 50V		—	—	12	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 2A	20	—	120	—

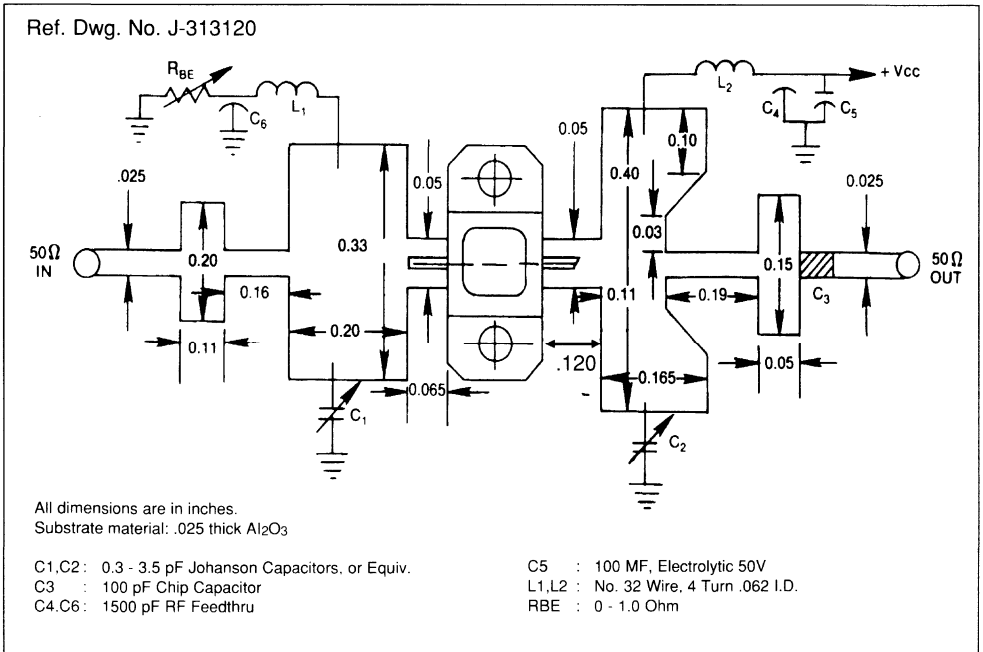
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 960 — 1215MHz	P <sub>IN</sub> = 13W	V <sub>CC</sub> = 50V	90	100	—	W
η <sub>c</sub>	f = 960 — 1215MHz	P <sub>IN</sub> = 13W	V <sub>CC</sub> = 50V	38	44	—	%
GP	f = 960 — 1215MHz	P <sub>IN</sub> = 13W	V <sub>CC</sub> = 50V	8.4	—	—	dB

Note: Pulse Width = 10μSec

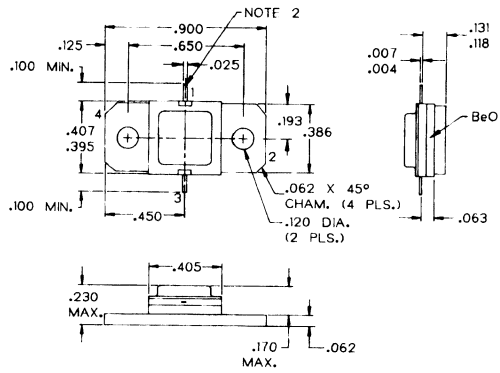
Duty Cycle = 10%

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



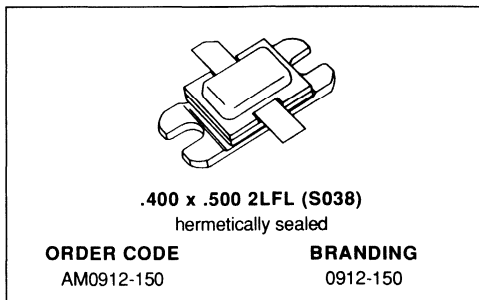
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

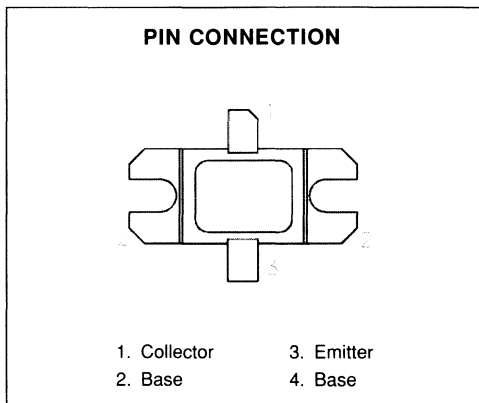
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 150 W MIN. WITH 7.5 dB GAIN
- BANDWIDTH = 255MHz



### DESCRIPTION

The AM0912-150 is designed for specialized avionics applications including Mode-S, TCAS and JTIDS, where power is provided under pulse formats utilizing short pulse widths and high burst or overall duty cycles.

The AM0912-150 is housed in the unique BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	300	W
I <sub>C</sub>	Device Current*	16.5	A
V <sub>CC</sub>	Collector-Supply Voltage*	35	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.57	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 60\text{mA}$	$I_E = 0\text{mA}$		55	65	—	V
$BV_{EBO}$	$I_E = 10\text{mA}$	$I_C = 0\text{mA}$		3.5	—	—	V
$BV_{CES}$	$I_C = 100\text{mA}$			55	—	—	V
$I_{CES}$	$V_{CE} = 35\text{V}$			—	—	25	mA
$h_{FE}$	$V_{CE} = 5\text{V}$	$I_C = 5\text{A}$		20	—	—	—

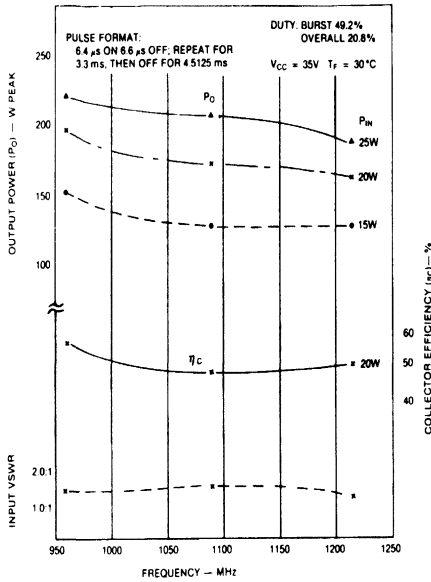
## DYNAMIC

Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{OUT}$	$f = 960 \text{ — } 1215\text{MHz}$	$P_{IN} = 26.7\text{W}$	$V_{CC} = 35\text{V}$		150	—	—	W
$\eta_C$	$f = 960 \text{ — } 1215\text{MHz}$	$P_{IN} = 26.7\text{W}$	$V_{CC} = 35\text{V}$		45	—	—	%
$G_P$	$f = 960 \text{ — } 1215\text{MHz}$	$P_{IN} = 26.7\text{W}$	$V_{CC} = 35\text{V}$		7.5	—	—	dB

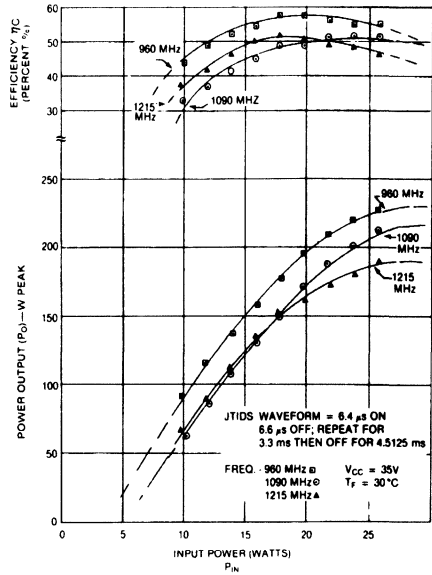
Note: Pulse Format: 6.4  $\mu\text{S}$  on 6.6  $\mu\text{S}$  off; repeat for 3.3 ms, then off for 4.5125 ms  
Duty Cycle: Burst 49.2% overall 20.8%

TYPICAL PERFORMANCE

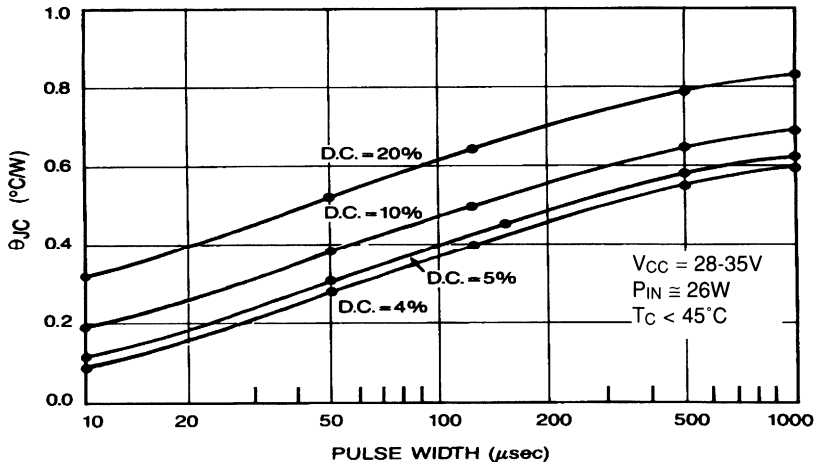
TYPICAL POWER INPUT, POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY



POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT

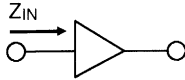


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

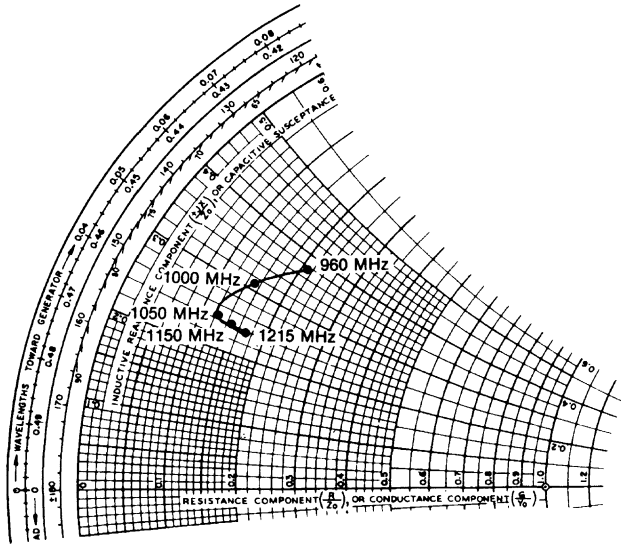


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

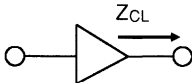


$P_{IN} = 26.7\text{ W}$   
 $V_{CC} = 35\text{ V}$   
 $Z_{O^*} = 10\text{ ohms}$

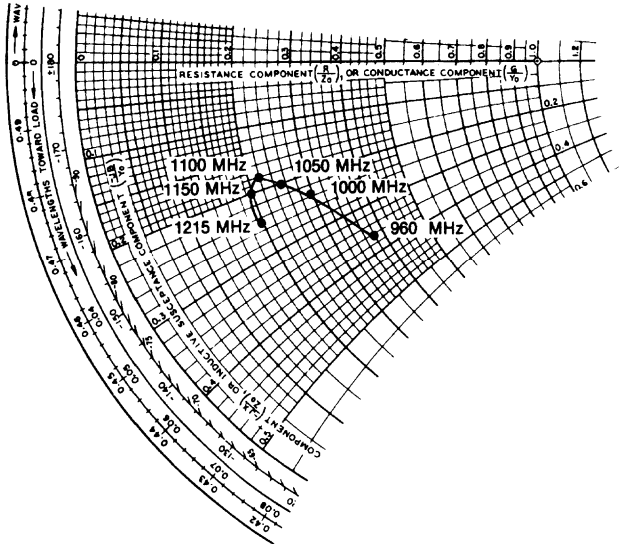


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 960 MHz	$2.1 + j 3.8$	$3.8 - j 3.6$
• = 1000 MHz	$1.5 + j 3.1$	$3.0 - j 2.4$
M = 1050 MHz	$1.2 + j 2.5$	$2.5 - j 2.0$
• = 1150 MHz	$1.5 + j 2.4$	$2.0 - j 2.0$
H = 1215 MHz	$1.7 + j 2.4$	$2.0 - j 2.5$

TYPICAL COLLECTOR LOAD IMPEDANCE



$P_{IN} = 26.7\text{ W}$   
 $V_{CC} = 35\text{ V}$   
 $Z_{O^*} = 10\text{ ohms}$

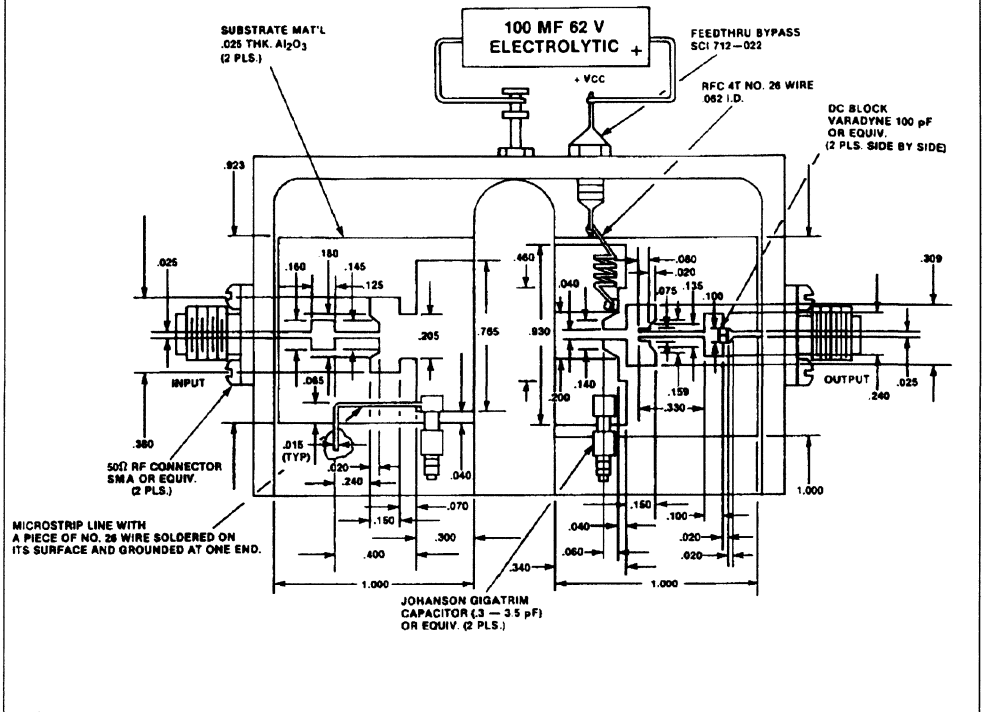


\*Normalized Impedance



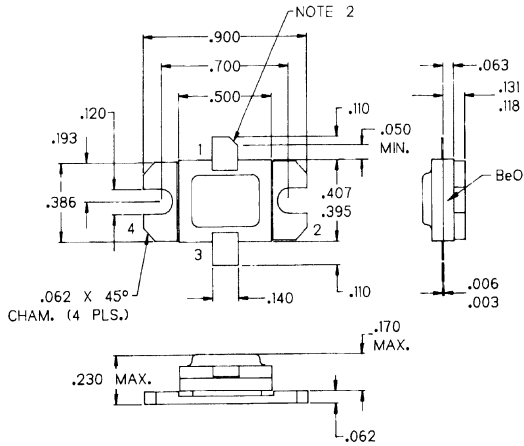
## TEST CIRCUIT

Ref: Dwg. No. C127513



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F

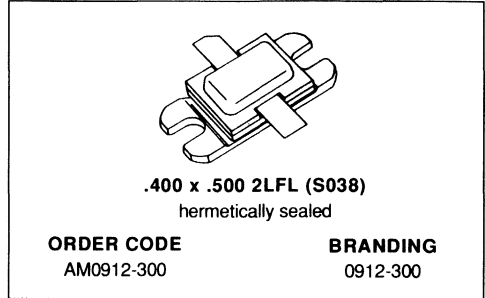


NOTES:

- 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
- 2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 15:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 300 W MIN. WITH 7.0 dB GAIN
- BANDWIDTH 255 MHz

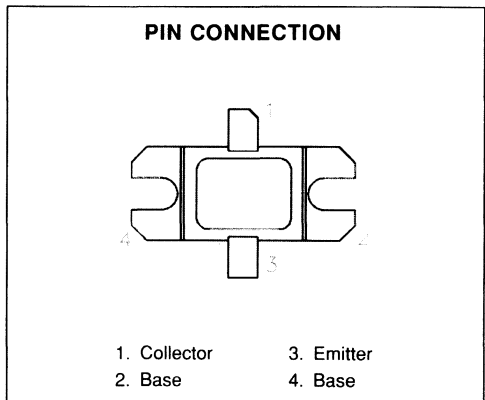

**DESCRIPTION**

The AM0912-300 avionics power transistor is a broadband, high peak pulse power device specifically designed for avionics applications requiring broad bandwidth with moderate duty cycle and pulse width constraints such as ground/ship based DME/TACAN.

The AM0912-300 is also designed for specialized applications where reduced power is provided under pulse formats utilizing short pulse widths and high burst or overall duty cycles.

This device is capable of withstanding 15:1 VSWR mismatch load condition at any phase angle under full rated conditions.

The AM0912-300 is housed in the unique BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	940	W
I <sub>C</sub>	Device Current*	24	A
V <sub>CC</sub>	Collector-Supply Voltage*	50	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.16	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	65	80	—	V
$BV_{EBO}$	$I_E = 15mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CER}$	$I_C = 50mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	30	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	10	—	—	—

**DYNAMIC**

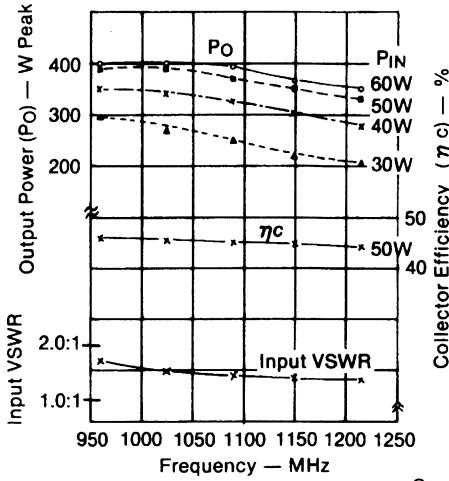
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 960 - 1215MHz$	$P_{IN} = 60W$	$V_{CC} = 50V$	300	330	—	W
$\eta_C$	$f = 960 - 1215MHz$	$P_{IN} = 60W$	$V_{CC} = 50V$	38	45	—	%
$G_P$	$f = 960 - 1215MHz$	$P_{IN} = 60W$	$V_{CC} = 50V$	7.0	7.4	—	dB

Note: Pulse Width =  $10\mu Sec$

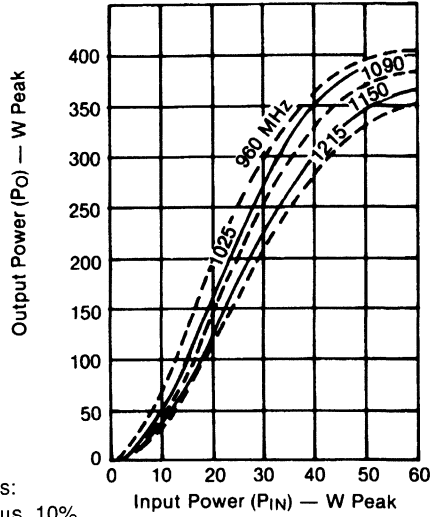
Duty Cycle = 10%

TYPICAL PERFORMANCE

TYPICAL BROADBAND RESPONSE

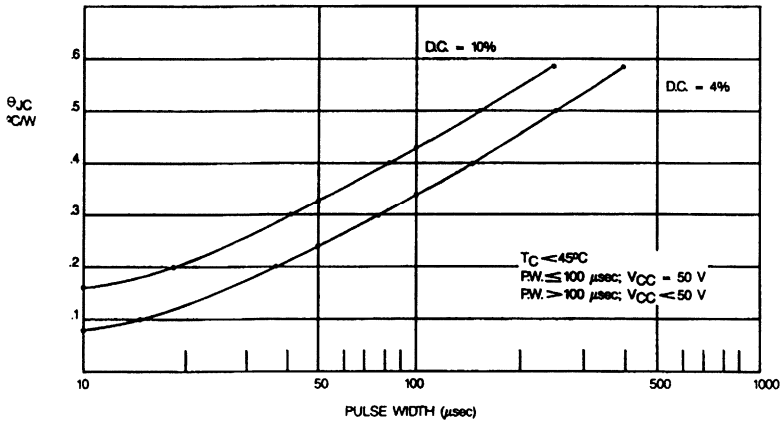


TYPICAL POWER OUTPUT vs POWER INPUT



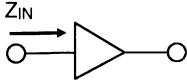
Conditions:  
 PW = 10  $\mu$ s, 10%  
 $V_{CC}$  = 50 V

MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

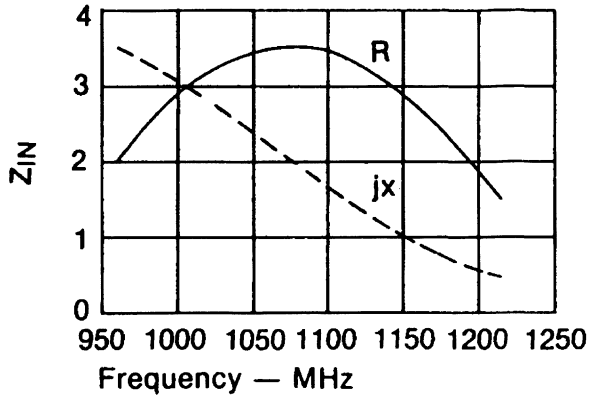


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

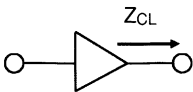


$P_{IN} = 60\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 $Z_O = 50\text{ ohms}$

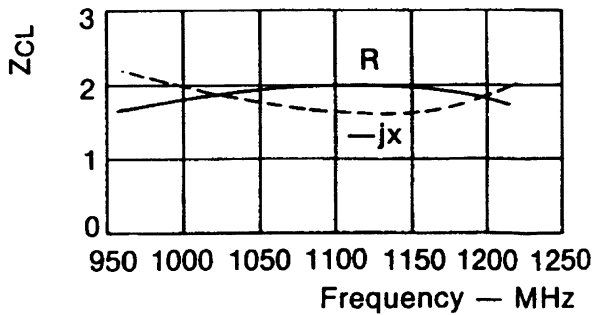


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 960 MHz	$2.0 + j\ 3.6$	$1.7 - j\ 2.2$
M = 1090 MHz	$3.5 + j\ 1.7$	$2.0 - j\ 1.7$
H = 1215 MHz	$1.6 + j\ 0.5$	$1.8 - j\ 2.0$

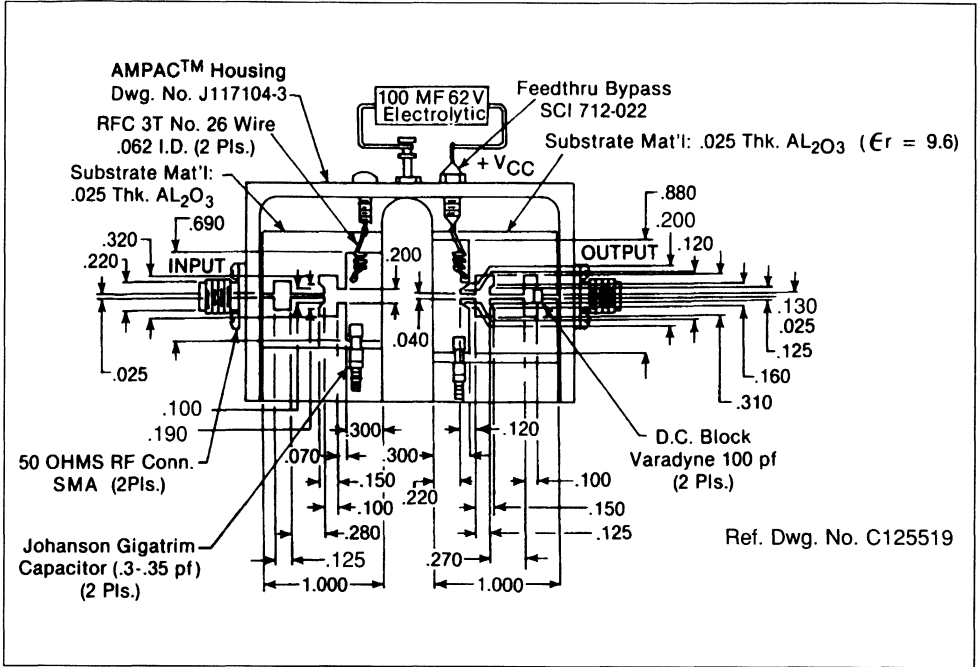
TYPICAL COLLECTOR LOAD IMPEDANCE



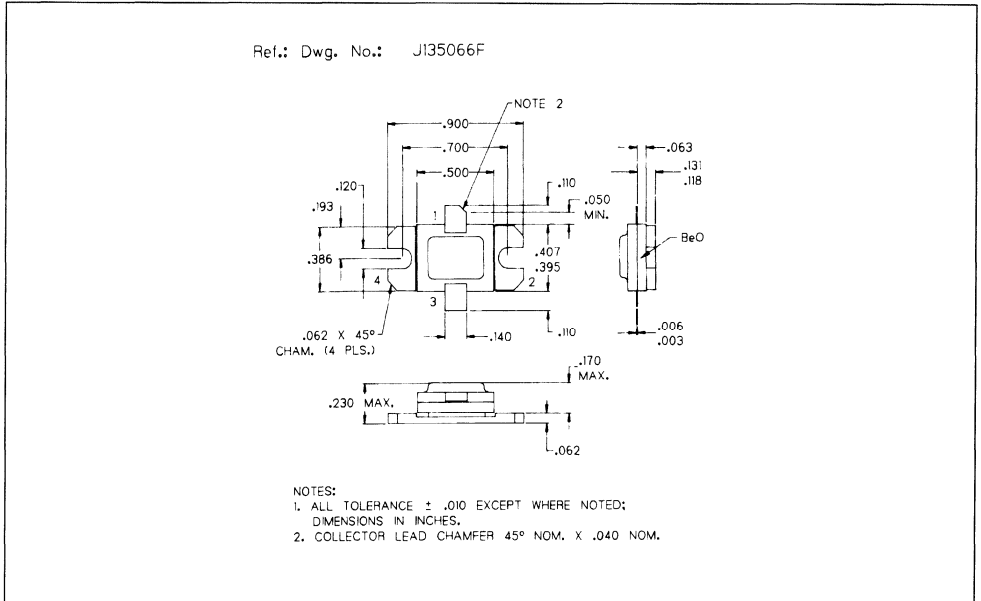
$P_{IN} = 60\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 $Z_O = 50\text{ ohms}$



TEST CIRCUIT



PACKAGE MECHANICAL DATA



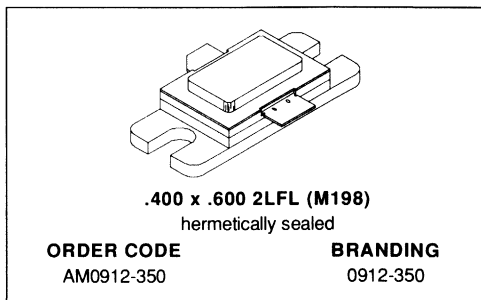




**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

ADVANCE PRODUCT INFORMATION

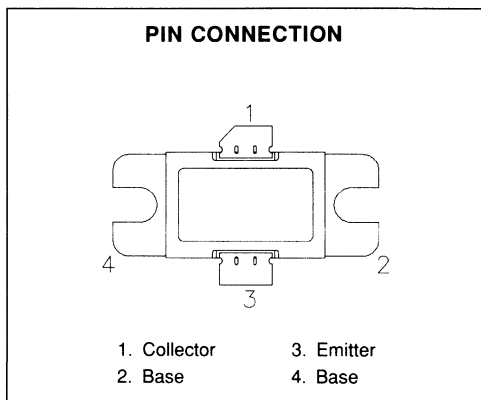
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- SIXPAC™ METAL/CERAMIC PACKAGE
- $P_{OUT} = 350$  W MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

The AM0912-350 avionics power transistor is a broadband, high peak pulse power device specifically designed for avionics applications requiring broad bandwidth with moderate duty cycle and pulse width constraints such as ground/ship based DME/TACAN.

The AM0912-350 is also designed for specialized applications using high burst or overall duty cycles. The device is capable of withstanding 10:1 mismatch load condition at any phase angle under full rated conditions.

AM0912-350 is housed in the SIXPAC™ Hermetic Metal/Ceramic package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 75^{\circ}C$ )	1140	W
$I_C$	Device Current*	26	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.15	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	70	—	—	V
$BV_{EBO}$	$I_E = 30mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	70	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 50V$	—	—	40	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1.0A$	10	—	—	—

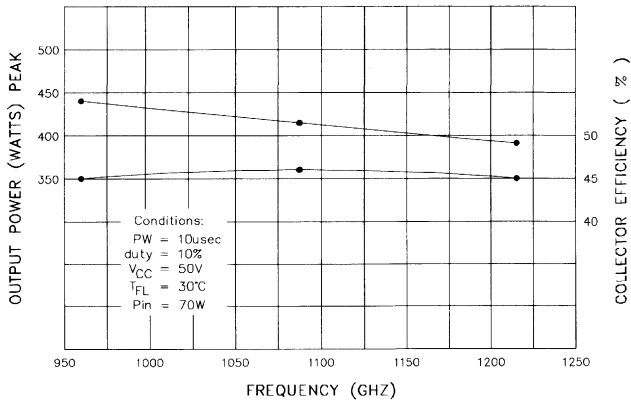
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 960 - 1215MHz$	$P_{IN} = 70W$	$V_{CC} = 50V$	350	—	—	W
$\eta_C$	$f = 960 - 1215MHz$	$P_{IN} = 70W$	$V_{CC} = 50V$	38	—	—	%
$G_P$	$f = 960 - 1215MHz$	$P_{IN} = 70W$	$V_{CC} = 50V$	7.0	—	—	dB

Note: Pulse Width =  $10\mu Sec$   
 Duty Cycle = 10%

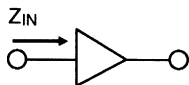
**TYPICAL PERFORMANCE**

**POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**

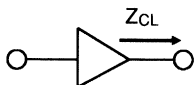


**IMPEDANCE DATA**

**TYPICAL INPUT IMPEDANCE**



**TYPICAL COLLECTOR LOAD IMPEDANCE**

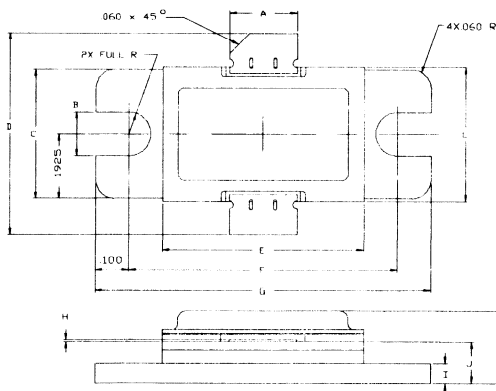


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 960 MHz	0.73 + j 1.85	0.83 - j 0.74
M = 1090 MHz	1.24 + j 0.51	1.18 - j 0.73
H = 1215 MHz	1.49 - j 0.08	0.62 + j 1.10

P<sub>IN</sub> = 70W  
 V<sub>CC</sub> = 50V  
 Normalized to 50 ohms

**PACKAGE MECHANICAL DATA**

Ref.: Dwg. No. 12-0198



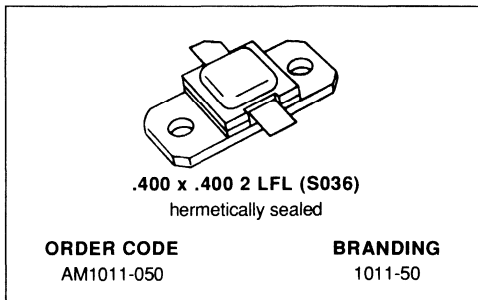
SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.195/4.95	.205/5.21	K		.230/5.84
B	.130/3.30		L	.393/9.98	.410/10.41
C	.380/9.65	.390/9.91			
D	.570/14.48				
E	.590/14.99	.610/15.49			
F	.795/20.19	.805/20.45			
G	.995/25.27	1.005/25.53			
H	.002/0.05	.006/0.15			
I	.055/1.40	.065/1.65			
J	.110/2.79	.130/3.30			



**RF & MICROWAVE TRANSISTORS  
 L-BAND AVIONICS APPLICATIONS**

PRELIMINARY DATA

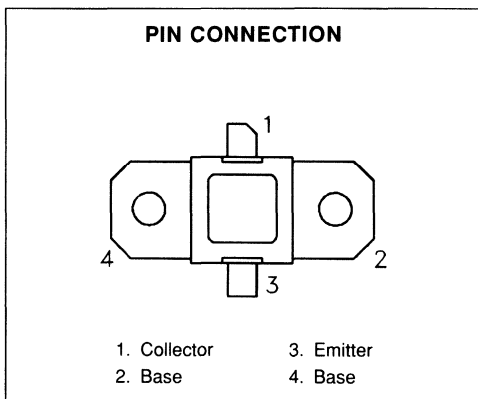
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 45 \text{ W MIN. WITH } 8.8 \text{ dB GAIN}$


**DESCRIPTION**

The AM1011-050 device is a high power Class C transistor specifically designed for L-Band Avionics transponder/interrogator pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding severe output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-050 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}\text{C}$ )	105	W
$I_C$	Device Current*	4	A
$V_{CC}$	Collector-Supply Voltage*	40	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.4	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

STATIC

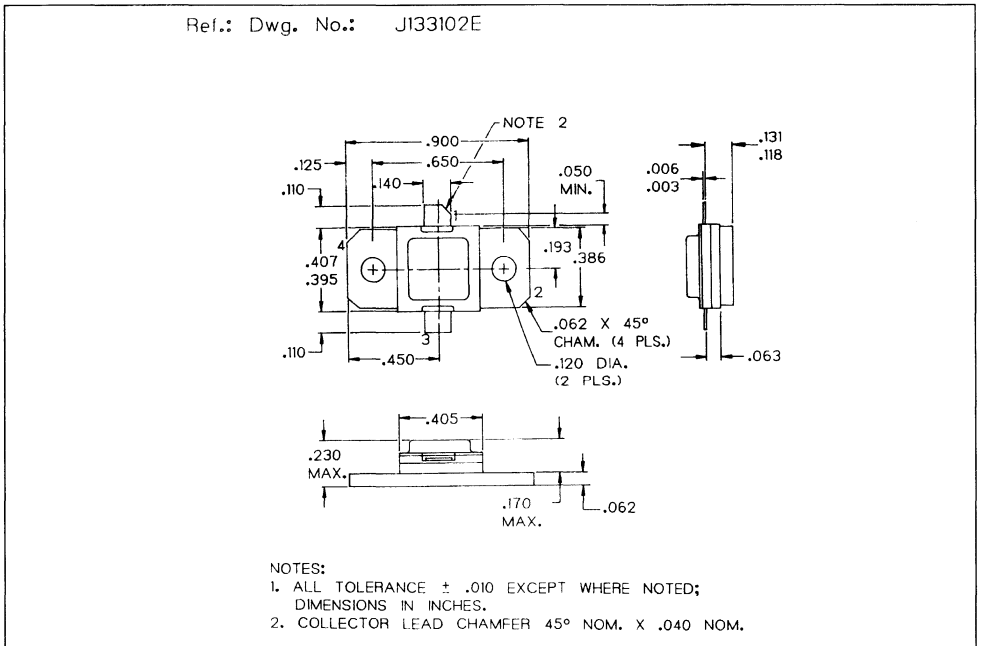
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 15mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CES}$	$I_C = 15mA$		65	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 36V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	10	—	200	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1030MHz$	$P_{IN} = 6W$	$V_{CC} = 36V$	45	—	—	W
$\eta_C$	$f = 1030MHz$	$P_{IN} = 6W$	$V_{CC} = 36V$	48	—	—	%
$G_P$	$f = 1030MHz$	$P_{IN} = 6W$	$V_{CC} = 36V$	8.8	—	—	dB

Note: Pulse Width = 250µSec  
 Duty Cycle = 6%

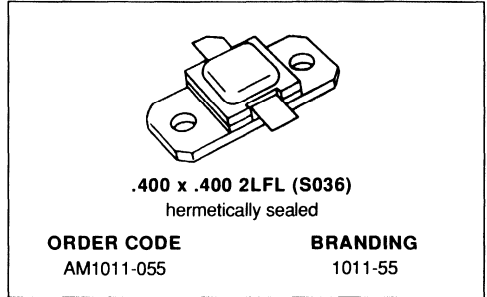
PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 L-BAND AVIONICS APPLICATIONS**

PRELIMINARY DATA

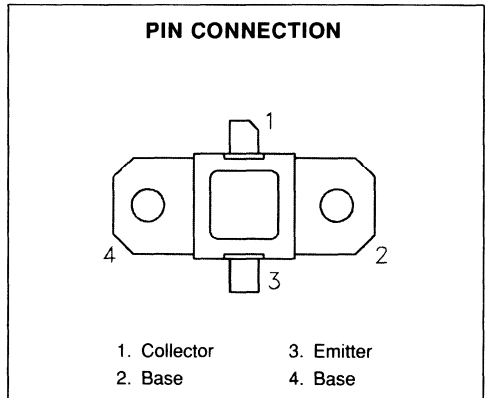
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 55 \text{ W MIN. WITH } 9.2 \text{ dB GAIN}$


**DESCRIPTION**

The AM1011-055 device is a high power Class C transistor specifically designed for L-Band Avionics transponder/interrogator output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 10:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-055 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}\text{C}$ )	91	W
$I_c$	Device Current*	3.79	A
$V_{CC}$	Collector-Supply Voltage*	50	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.1	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

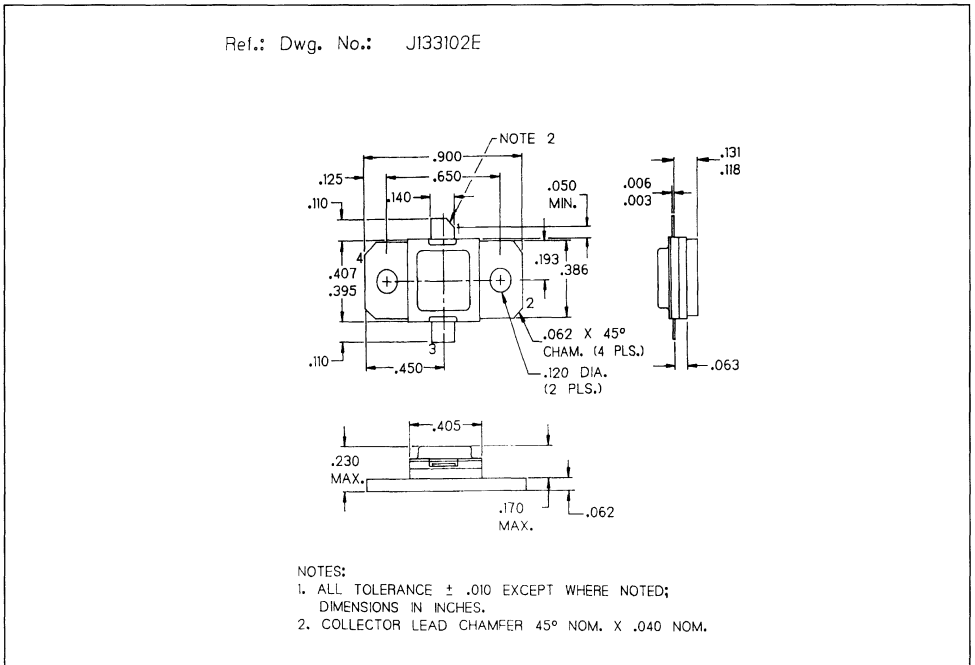
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 7.5mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 3mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 7.5mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	4	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	5	—	200	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090MHz$	$P_{IN} = 6.6W$	$V_{CC} = 50V$	55	—	—	W
$\eta_C$	$f = 1090MHz$	$P_{IN} = 6.6W$	$V_{CC} = 50V$	48	—	—	%
$G_P$	$f = 1090MHz$	$P_{IN} = 6.6W$	$V_{CC} = 50V$	9.2	—	—	dB

Note: Pulse Width = 32  $\mu$ S  
 Duty Cycle = 2%

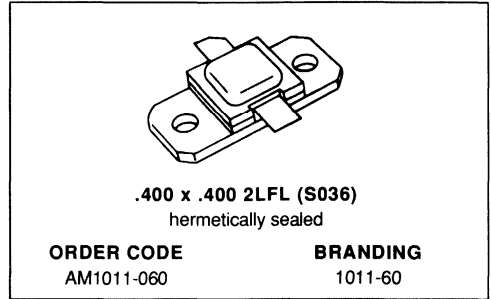
**PACKAGE MECHANICAL DATA**





**RF & MICROWAVE TRANSISTORS  
 L-BAND AVIONICS APPLICATIONS**

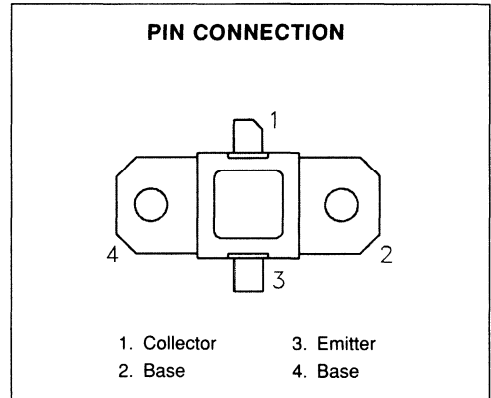
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 60$  W MIN. WITH 10 dB GAIN


**DESCRIPTION**

The AM1011-060 device is a high power Class C transistor specifically designed for L-Band Avionics transponder/interrogator pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding 10:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-060 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	130	W
$I_c$	Device Current*	4	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.1	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 12mA$	$I_E = 0mA$	70	—	—	V
$BV_{EBO}$	$I_E = 4mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 12mA$	$R_{BE} = 10\Omega$	70	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	4	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	10	—	200	—

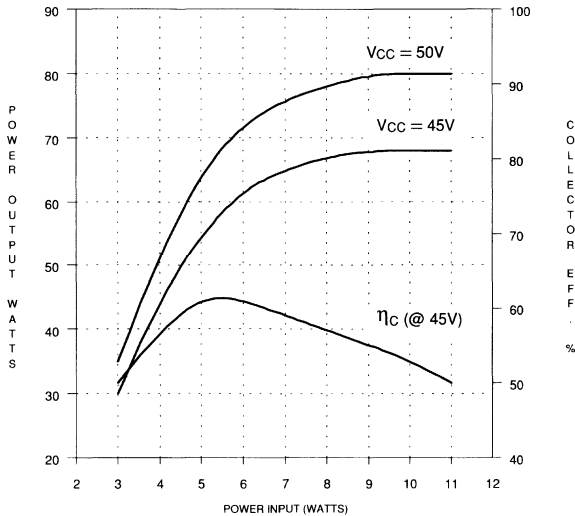
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090MHz$	$P_{IN} = 6W$	$V_{CC} = 50V$	60	72	—	W
$\eta_C$	$f = 1090MHz$	$P_{IN} = 6W$	$V_{CC} = 50V$	48	60	—	%
GP	$f = 1090MHz$	$P_{IN} = 6W$	$V_{CC} = 50V$	10	10.8	—	dB

Note: Pulse Width = 100 $\mu$ Sec  
 Duty Cycle = 4%

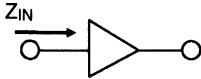
**TYPICAL PERFORMANCE**

**TYPICAL POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**

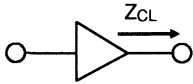


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

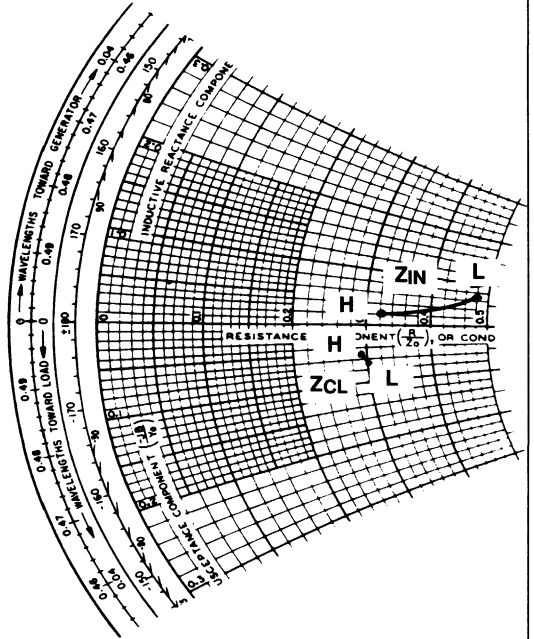


TYPICAL COLLECTOR LOAD IMPEDANCE

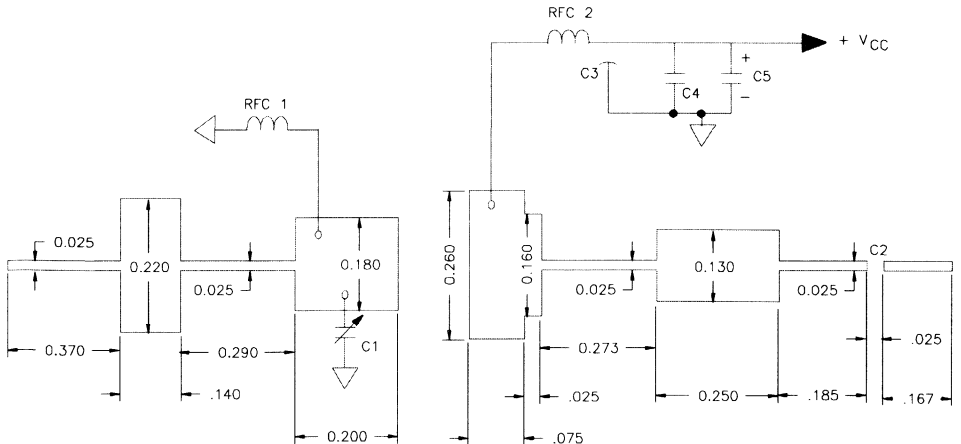


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1030 MHz	24 + j 3.8	15.0 - j 3.2
H = 1090 MHz	16.4 + j 0.6	14.9 - j 2.5

P<sub>IN</sub> = 6 W  
 V<sub>CC</sub> = 50 V  
 Normalized to 50 ohms



TEST CIRCUIT



All dimensions are in inches.  
 Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub>

RFC 1: Gold Plated Ni Strap  
 0.400 Long, 0.035 Wide, 0.005 Thick

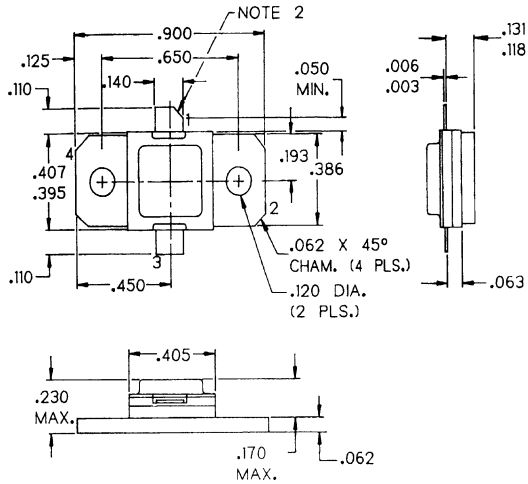
RFC 2: No. 26 Wire, 4 Turn .062 I.D.

C1 : 0.6—4.5 pF Johanson Gigatrim Capacitor

C2 : 100 pF Chip Capacitor  
 C3 : 1500 pF Filtercon Feedthrough  
 C4 : 1 μF, Ceramic Capacitor  
 C5 : 100 μF, Electrolytic Capacitor

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: JI33102E

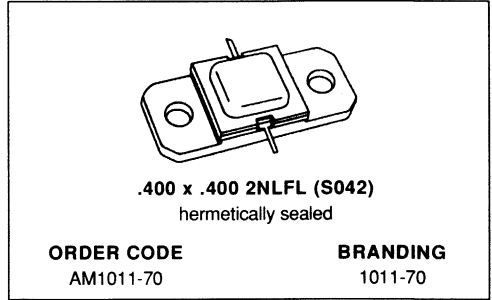


NOTES:

- 1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
- 2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

**RF & MICROWAVE TRANSISTORS  
 L-BAND AVIONICS APPLICATIONS**

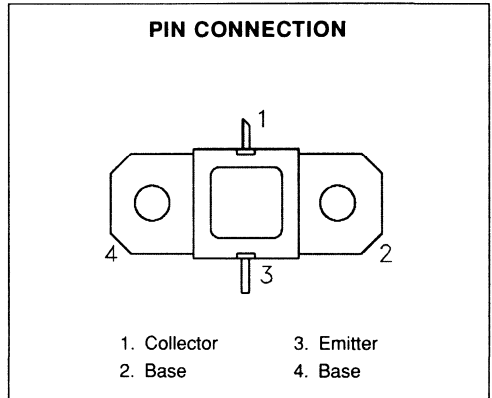
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 70$  W MIN. WITH 6.7 dB GAIN


**DESCRIPTION**

The AM1011-070 device is a high power Class C transistor specifically designed for L-Band Avionics transponder/interrogator pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding severe output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-070 is supplied in the AMPACT™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	200	W
$I_C$	Device Current*	8.0	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.68	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$		55	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$		3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$		55	—	—	V
$I_{CES}$	$V_{CE} = 35V$			—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2mA$		20	—	200	—

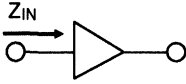
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090\text{ MHz}$	$P_{IN} = 15W$	$V_{CC} = 28V$	70	—	—	W
$\eta_C$	$f = 1090\text{ MHz}$	$P_{IN} = 15W$	$V_{CC} = 28V$	45	—	—	%
$G_P$	$f = 1090\text{ MHz}$	$P_{IN} = 15W$	$V_{CC} = 28V$	6.7	—	—	dB

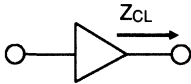
Note: Pulse Width = 100 $\mu$ Sec  
 Duty Cycle = 2%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

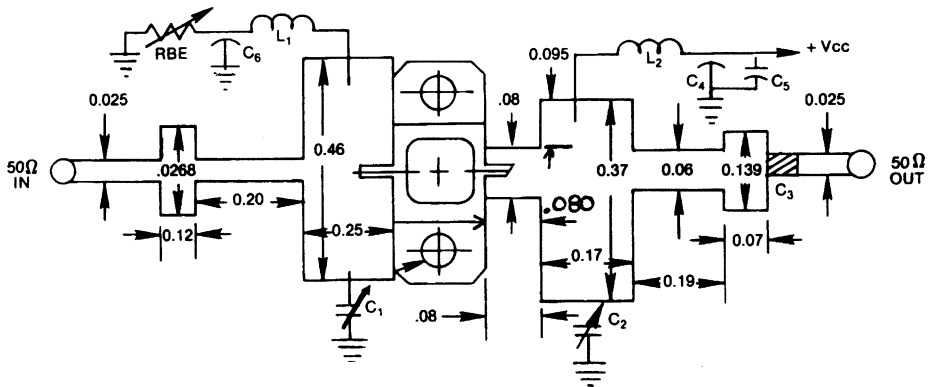


$P_{IN} = 15 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 Normalized to 50 ohms

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1025 MHz	$4.7 + j 4.7$	$3.6 + j 4.3$
H = 1090 MHz	$4.7 + j 3.9$	$3.3 + j 4.4$

TEST CIRCUIT

Ref. Dwg. No. J313119

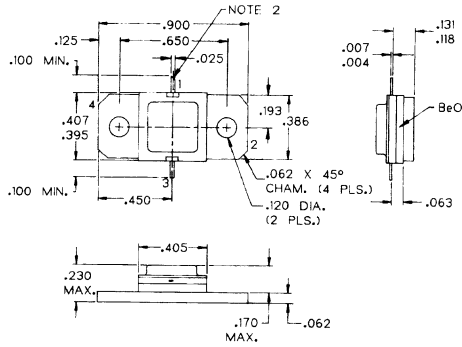


All dimensions are in inches.  
 Substrate material: .025 thick  $Al_2O_3$

- |   |  |
|---|--|
| C1 : 0.3—3.5 pF Johanson Gigatrim Capacitor | C5 : 100 MF Electrolytic Capacitor, 50V  |
| C2 : 0.3—3.5 pF Johanson Gigatrim Capacitor | C6 : 1500 pF Erie Feedthrough, or Equiv. |
| C3 : 100 pF Chip Capacitor                  | L1 : #32 Wire, 4 Turn .062 I.D.          |
| C4 : 1500 pF Erie Feedthru, or Equiv.       | L2 : #32 Wire, 4 Turn .062 I.D.          |
|   | RBE : 0 — 1.0 Ohm                        |

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F

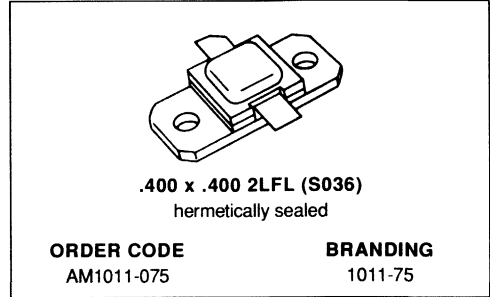


- NOTES:  
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.  
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 L-BAND AVIONICS APPLICATIONS**

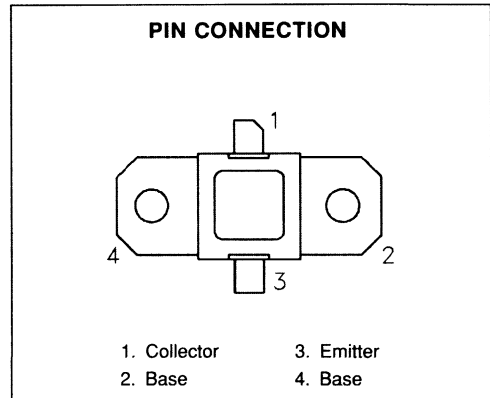
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 75$  W MIN. WITH 9.2 dB GAIN


**DESCRIPTION**

The AM1011-075 device is a high power Class C transistor specifically designed for L-Band Avionics transponder/interrogator pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 10:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-075 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	175	W
$I_C$	Device Current*	5.4	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.86	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 4mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 20mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	6	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1mA$	10	—	—	—

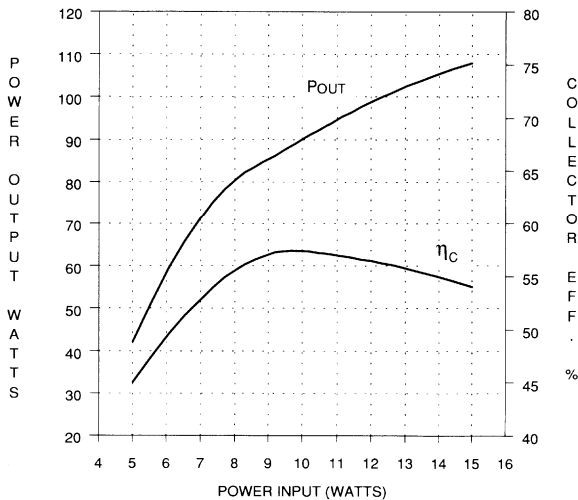
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090MHz$	$P_{IN} = 9W$ Peak	$V_{CC} = 50V$	75	84	—	W
$\eta_C$	$f = 1090MHz$	$P_{IN} = 9W$ Peak	$V_{CC} = 50V$	48	56	—	%
$G_P$	$f = 1090MHz$	$P_{IN} = 9W$ Peak	$V_{CC} = 50V$	9.2	9.7	—	dB

Note: Pulse Width =  $32\mu Sec$   
 Duty Cycle = 2%

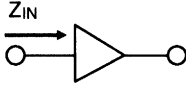
**TYPICAL PERFORMANCE**

**TYPICAL POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**

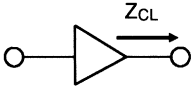


IMPEDANCE DATA

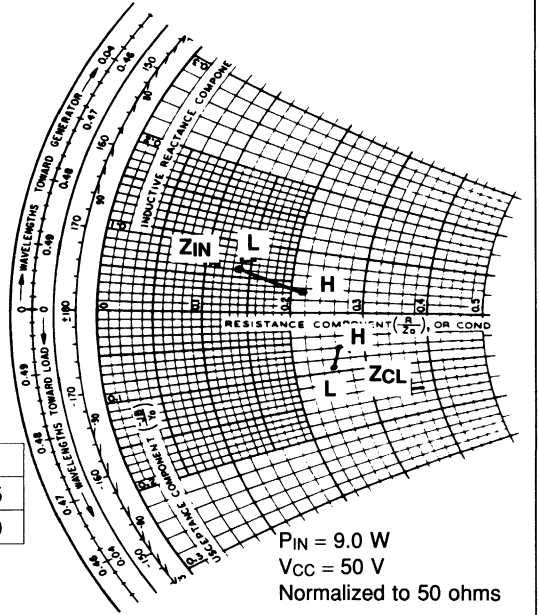
TYPICAL INPUT IMPEDANCE



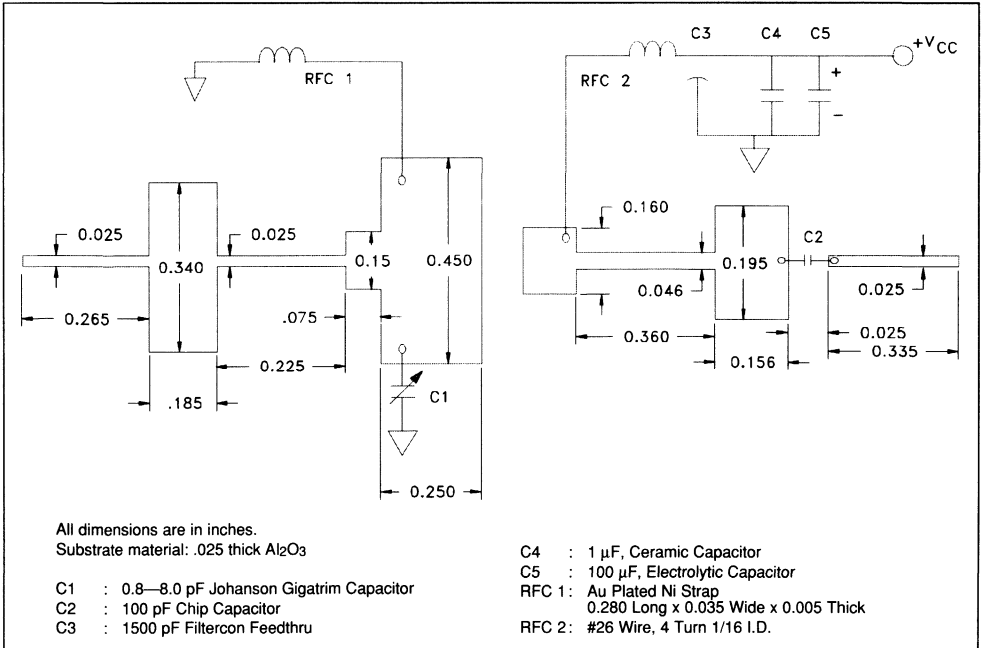
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1030 MHz	7.0 + j 3.0	12.5 - j 4.5
H = 1090 MHz	11.0 + j 1.5	13.0 - j 3.0

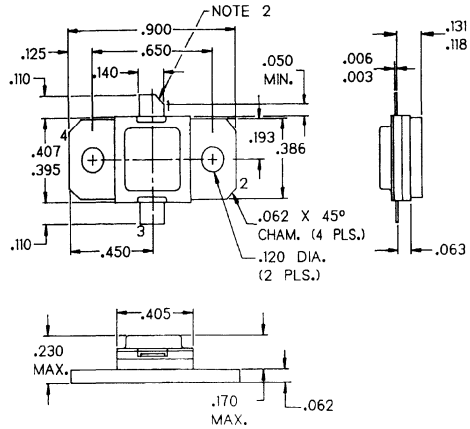


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



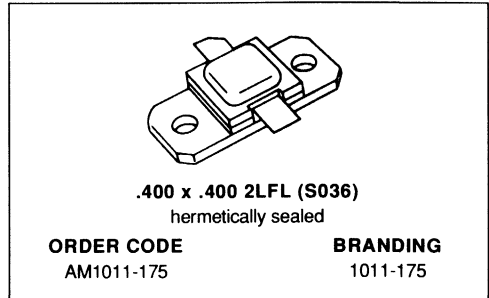
NOTES:

- 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
- 2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

**RF & MICROWAVE TRANSISTORS  
 L-BAND AVIONICS APPLICATIONS**

PRELIMINARY DATA

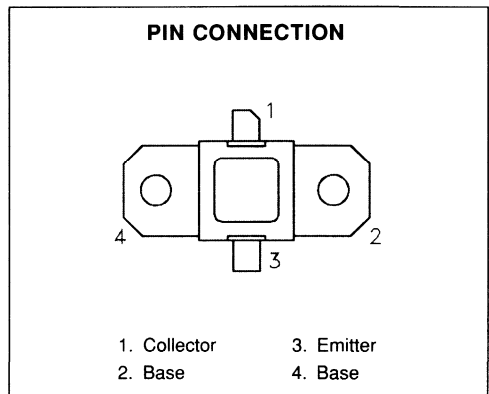
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 200 W MIN. WITH 8.0 dB GAIN


**DESCRIPTION**

The AM1011-175 device is a high power Class C transistor specifically designed for L-Band Avionics transponder/interrogator output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 10:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-175 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	357	W
I <sub>C</sub>	Device Current*	15.9	A
V <sub>CC</sub>	Collector-Supply Voltage*	50	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.28	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

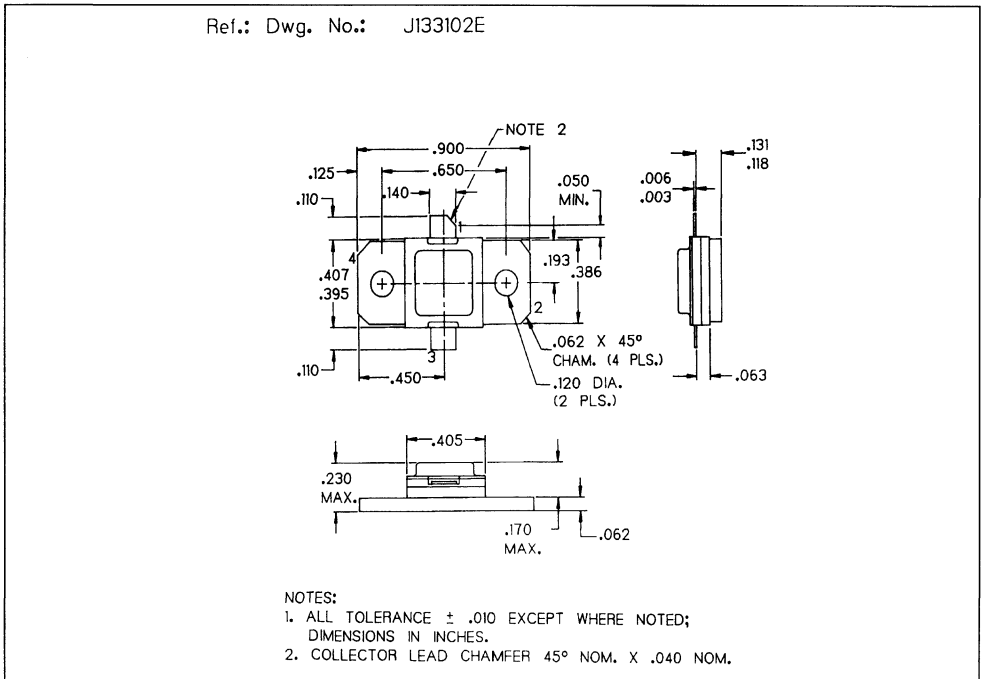
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 30mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 12mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 30mA$		65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	18	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	5	—	200	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090MHz$	$P_{IN} = 32W$	$V_{CC} = 50V$	200	—	—	W
$\eta_c$	$f = 1090MHz$	$P_{IN} = 32W$	$V_{CC} = 50V$	45	—	—	%
GP	$f = 1090MHz$	$P_{IN} = 32W$	$V_{CC} = 50V$	8.0	—	—	dB

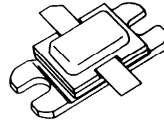
Note: Pulse Width =  $32\mu Sec$   
 Duty Cycle = 2%

**PACKAGE MECHANICAL DATA**



## RF & MICROWAVE TRANSISTORS L-BAND AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTING
- 3:1 VSWR CAPABILITY
- LOW RF THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 225 W MIN. WITH 7.5 dB GAIN



**.400 x .500 2LFL (S038)**  
hermetically sealed

**ORDER CODE**

AM1011-225

**BRANDING**

1011-225

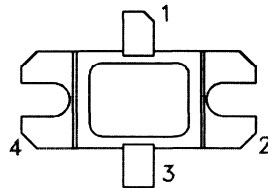
### DESCRIPTION

The AM1011-225 device is a high power Class C transistor specifically designed for L-Band Avionics transponder/interrogator pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 3:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-225 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with Input/Output matching structures.

### PIN CONNECTION



1. Collector

2. Base

3. Emitter

4. Base

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 100°C)	517	W
I <sub>c</sub>	Device Current*	23	A
V <sub>CC</sub>	Collector-Supply Voltage*	40	V
T <sub>J</sub>	Temperature Junction (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	0.29	°C/W
----------------------	----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 72mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_C = 0mA$	$I_E = 25mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 72mA$		65	—	—	V
$I_{CES}$	$V_{CE} = 36V$	$V_{BE} = 0V$	—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 9A$	10	—	200	—

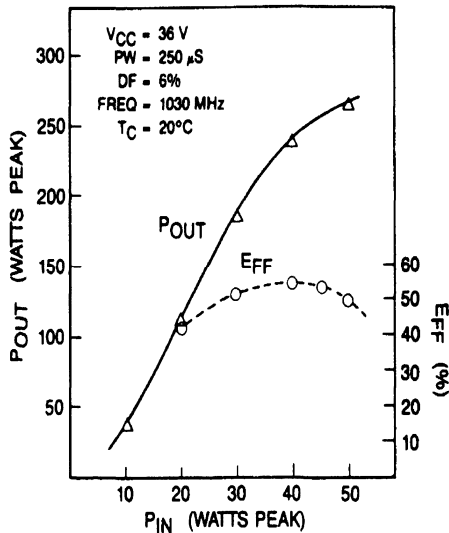
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1030MHz$	$P_{IN} = 40W$	$V_{CC} = 36V$	225	240	—	W
$\eta_C$	$f = 1030MHz$	$P_{IN} = 40W$	$V_{CC} = 36V$	48	53	—	%
GPB	$f = 1030MHz$	$P_{IN} = 40W$	$V_{CC} = 36V$	7.5	7.8	—	dB

Note: Pulse Width =  $250\mu Sec$   
 Duty Cycle = 6%

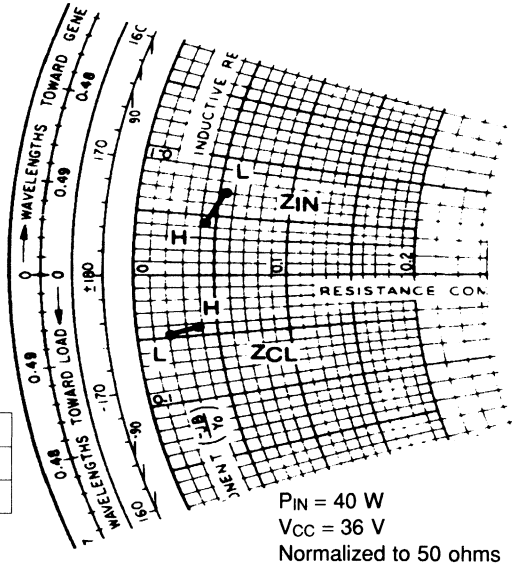
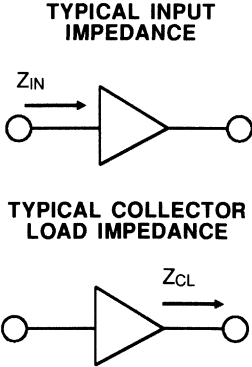
**TYPICAL PERFORMANCE**

**TYPICAL POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**





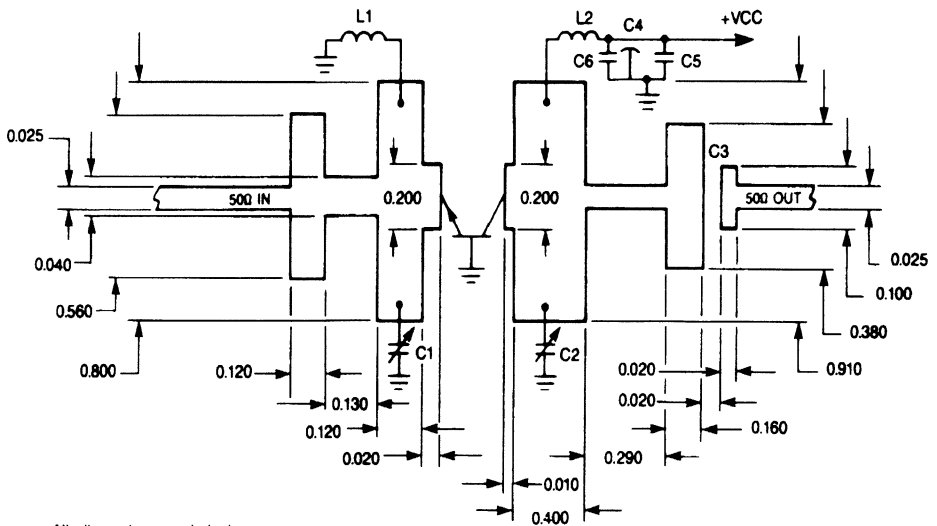
IMPEDANCE DATA



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1030 MHz	2.7 + j 4.0	1.0 - j 2.5
H = 1090 MHz	2.2 + j 2.1	2.0 - j 2.1

P<sub>IN</sub> = 40 W  
 V<sub>CC</sub> = 36 V  
 Normalized to 50 ohms

TEST CIRCUIT

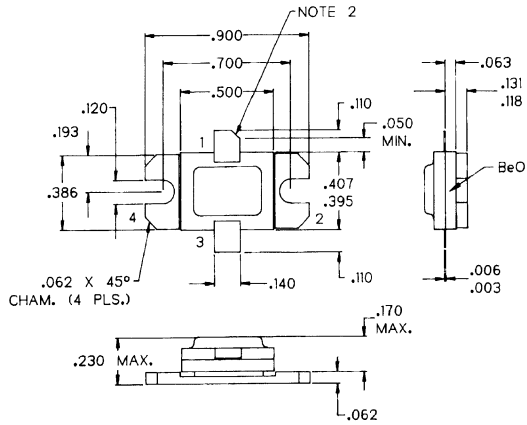


All dimensions are in inches.  
 Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub> (Er = 9.6)

- C1 : 0.6—4.5 pF Gigatrim Capacitor
- C2 : 0.8—8.0 pF Gigatrim Capacitor
- C3 : (2) 100 pF Chip Capacitors in Parallel
- C4 : 1500 pF Filtercon Feedthru
- C5 : 550 pF Chip Capacitor
- C6 : 550 pF Chip Capacitor
- L1 : Gold Plated Nickel Strap, 0.060 Inch Wide, 0.005 Inch Thick, 0.150 Inch Long
- L2 : #28 Wire, 2 Turn 1/16 Inch I.D.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F

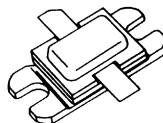


NOTES:

- 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
- 2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

**RF & MICROWAVE TRANSISTORS  
 L-BAND AVIONICS APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTING
- 3:1 VSWR CAPABILITY
- LOW RF THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 350$  W MIN. WITH 7.7 dB GAIN



**.400 x .500 2LFL (S038)**  
hermetically sealed

**ORDER CODE**  
AM1011-350

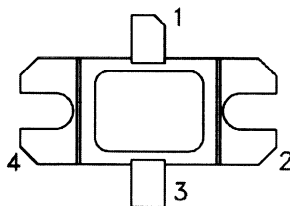
**BRANDING**  
1011-350

**DESCRIPTION**

The AM1011-350 device is a high power Class C transistor specifically designed for L-Band Avionics Mode-S transponder/interrogator pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 3:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-350 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with Input/Output matching structures.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	652	W
$I_c$	Device Current*	28	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Temperature Junction (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.23	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 72mA$	$I_E = 0mA$	70	—	—	V
$BV_{EBO}$	$I_C = 0mA$	$I_E = 25mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 72mA$		70	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$V_{BE} = 0V$	—	—	30	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 9A$	10	—	200	—

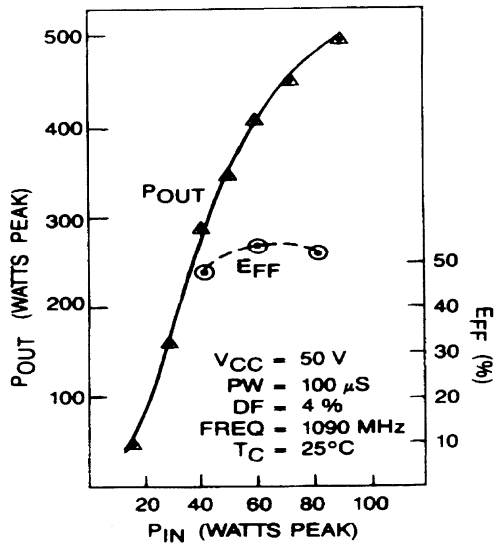
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090MHz$	$P_{IN} = 60W$	$V_{CC} = 50V$	350	380	—	W
$\eta_C$	$f = 1090MHz$	$P_{IN} = 60W$	$V_{CC} = 50V$	48	54	—	%
$G_{PB}$	$f = 1090MHz$	$P_{IN} = 60W$	$V_{CC} = 50V$	7.7	8.0	—	dB

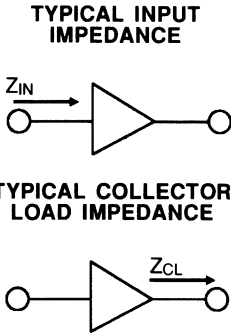
Note: Pulse Width = 100µSec  
 Duty Cycle = 4%

**TYPICAL PERFORMANCE**

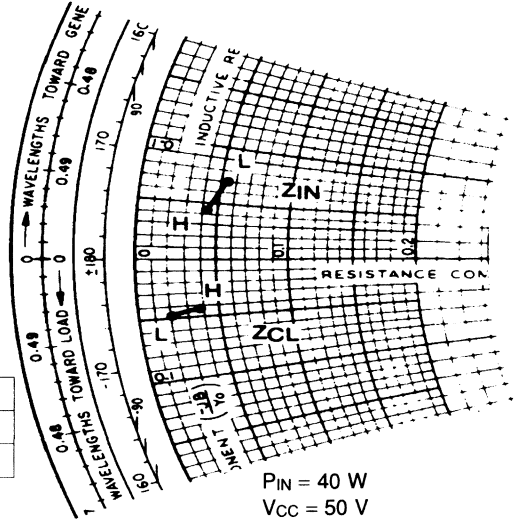
**TYPICAL POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**



IMPEDANCE DATA

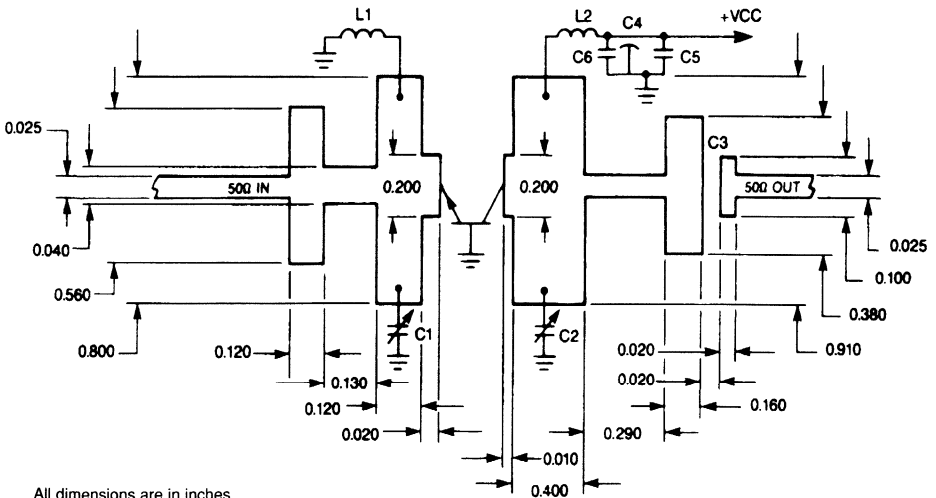


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1030 MHz	2.6 + j 3.5	1.0 - j 2.4
H = 1090 MHz	2.2 + j 2.1	1.9 - j 2.1



P<sub>IN</sub> = 40 W  
 V<sub>CC</sub> = 50 V  
 Normalized to 50 ohms

TEST CIRCUIT

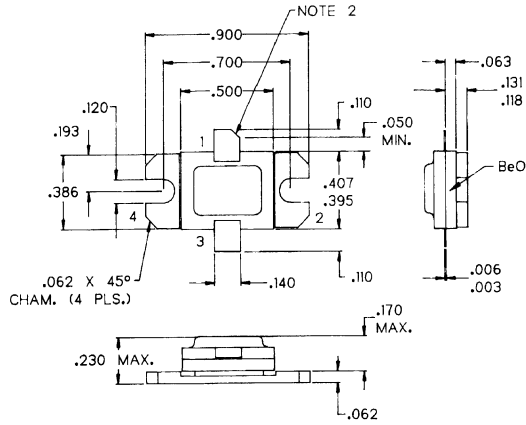


All dimensions are in inches.  
 Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub> (Er = 9.6)

- C1 : 0.6—4.5 pF Gigatrim Capacitor
- C2 : 0.8—8.0 pF Gigatrim Capacitor
- C3 : (2) 100 pF Chip Capacitors in Parallel
- C4 : 1500 pF Filtercon Feedthru
- C5 : 200 μF Electrolytic Capacitor
- C6 : 550 pF Chip Capacitor
- L1 : Gold Plated Nickel Strap, 0.060 Inch Wide, 0.005 Inch Thick, 0.150 Inch Long
- L2 : #28 Wire, 2 Turn 1/16 Inch I.D.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F

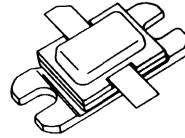


NOTES:

- 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
- 2. COLLECTOR LEAD CHAMFER  $45^\circ$  NOM. X  $.040$  NOM.

**RF & MICROWAVE TRANSISTORS  
 L-BAND AVIONICS APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 15:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 400$  W MIN. WITH 8.0 dB GAIN



**.400 x .500 2LFL (S038)**  
 hermetically sealed

**ORDER CODE**

AM1011-400

**BRANDING**

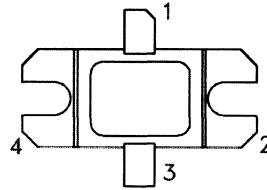
1011-400

**DESCRIPTION**

The AM1011-400 device is a high power Class C transistor specifically designed for TCAS and Mode-S pulsed output and driver applications.

This device is designed for operation under moderate pulse width and duty cycle pulse conditions and is capable of withstanding 15:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-400 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package Input/Output matching structures.

**PIN CONNECTION**


1. Collector

2. Base

3. Emitter

4. Base

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	880	W
$I_C$	Device Current*	24	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.17	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	65	—	—	V	
$BV_{EBO}$	$I_E = 15mA$	$I_C = 0mA$	3.5	—	—	V	
$BV_{CER}$	$I_C = 50mA$	$R_{BE} = 10\Omega$	65	—	—	V	
$I_{CES}$	$V_{BE} = 50V$	$V_{CE} = 0V$	—	—	30	mA	
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	10	—	—	—	

**DYNAMIC**

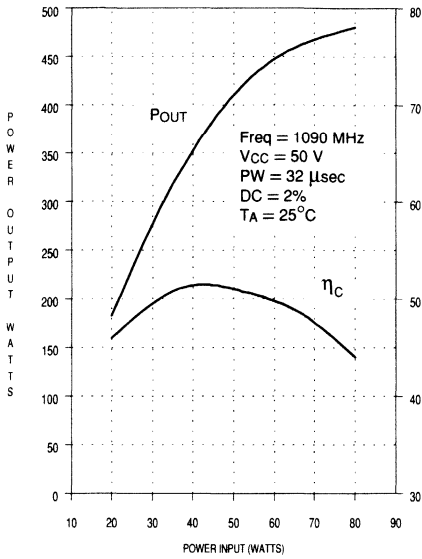
Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090MHz$	$P_{IN} = 63W$	$V_{CC} = 50V$	400	450	—	W	
$\eta_C$	$f = 1090MHz$	$P_{IN} = 63W$	$V_{CC} = 50V$	45	50	—	%	
$G_P$	$f = 1090MHz$	$P_{IN} = 63W$	$V_{CC} = 50V$	8.0	8.5	—	dB	

Note: Pulse Width =  $32\mu Sec$   
 Duty Cycle = 2%

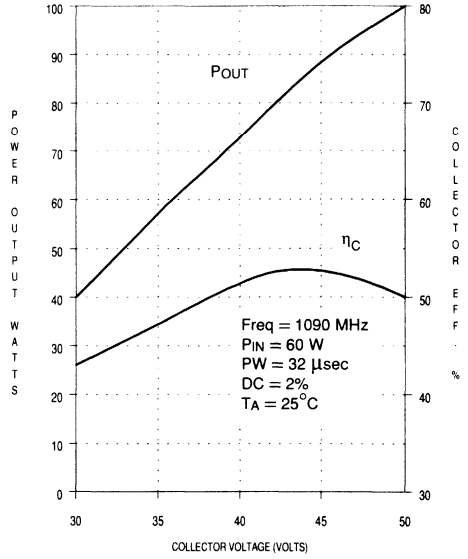


TYPICAL PERFORMANCE

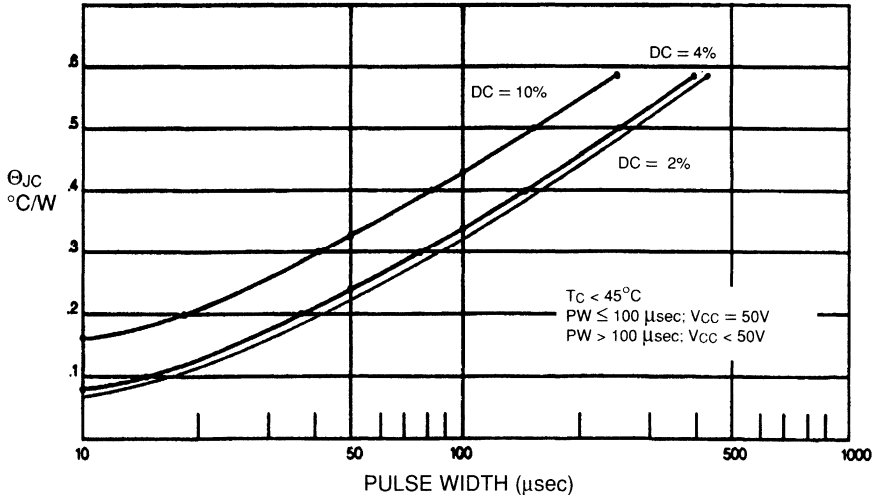
TYPICAL NARROWBAND POWER AMPLIFIER



TYPICAL RELATIVE OUTPUT POWER & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE

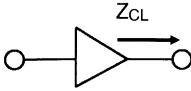


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

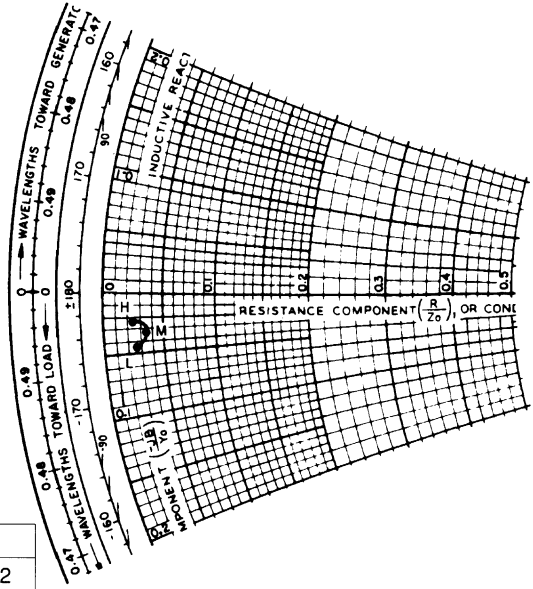


IMPEDANCE DATA

TYPICAL COLLECTOR LOAD IMPEDANCE

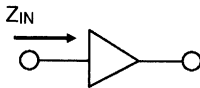


$P_{IN} = 63 \text{ W}$   
 $V_{CC} = +50 \text{ V}$   
 $Z_{O}^* = 50 \Omega$

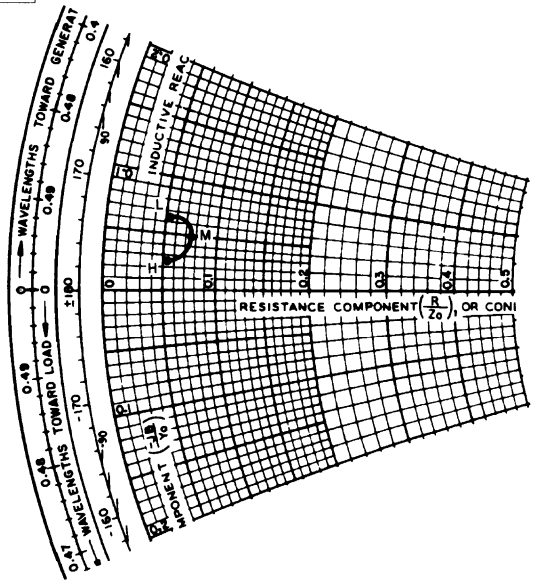


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1025 MHz	$2.4 + j 3.2$	$1.4 - j 2.2$
M = 1090 MHz	$3.8 + j 2.5$	$1.6 - j 1.6$
H = 1150 MHz	$2.3 + j 1.3$	$1.2 - j 1.1$

TYPICAL INPUT IMPEDANCE

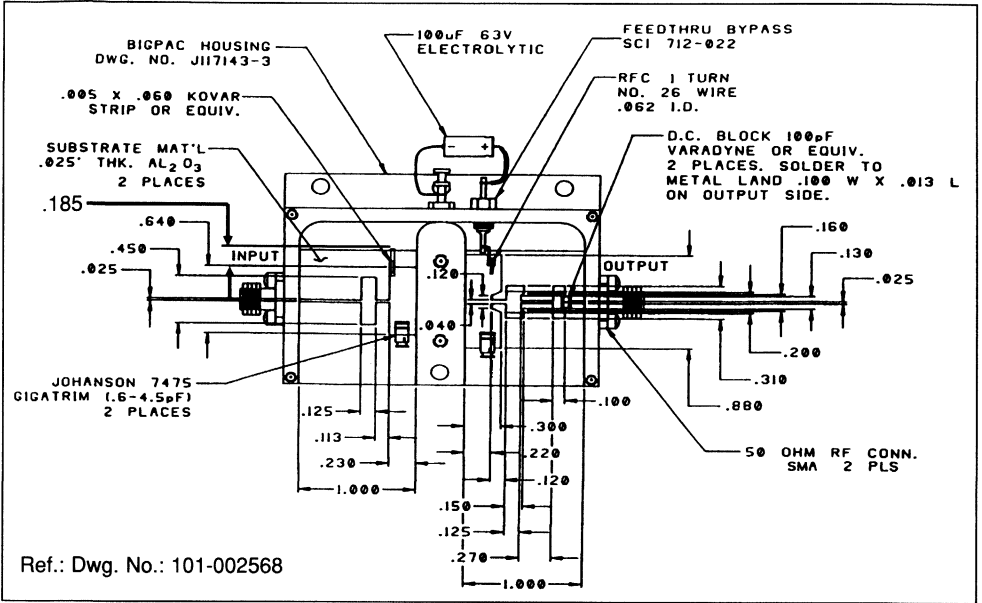


$P_{IN} = 63 \text{ W}$   
 $V_{CC} = +50 \text{ V}$   
 $Z_{O}^* = 50 \Omega$

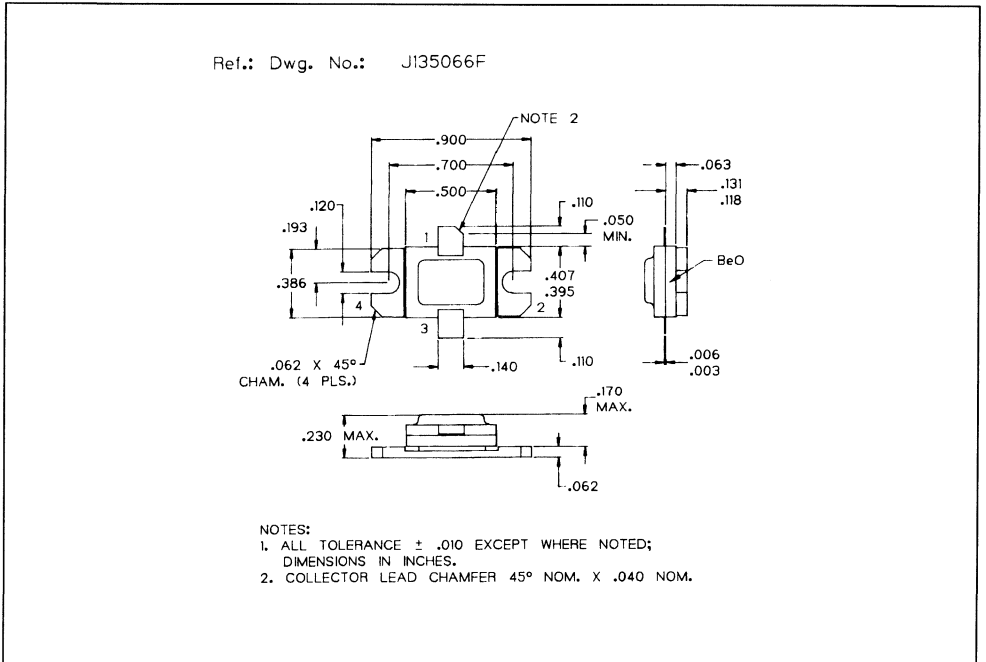


\*Normalized Impedance

TEST CIRCUIT



PACKAGE MECHANICAL DATA

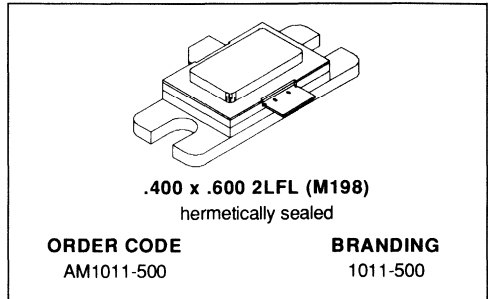




**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

## ADVANCED PRODUCT INFORMATION

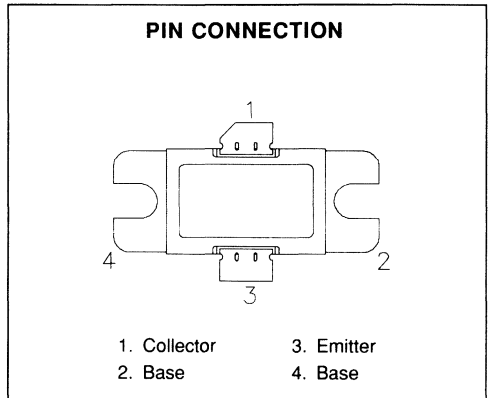
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- SIXPAC™ METAL/CERAMIC PACKAGE
- $P_{OUT} = 500 \text{ W MIN. WITH } 8.5 \text{ dB GAIN}$


**DESCRIPTION**

The AM1011-500 device is a high power Class C transistor specifically designed for L-Band Avionic Mode-S transponder/interrogator pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 3:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1011-500 is supplied in the SIXPAC™ Hermetic metal/ceramic package with input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}\text{C}$ )	1,360	W
$I_C$	Device Current*	27	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.11	$^{\circ}\text{C/W}$
---------------	-----------------------------------	------	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	70	—	—	V
$BV_{EBO}$	$I_E = 30mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	70	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 50V$	—	—	40	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1.0A$	10	—	—	—

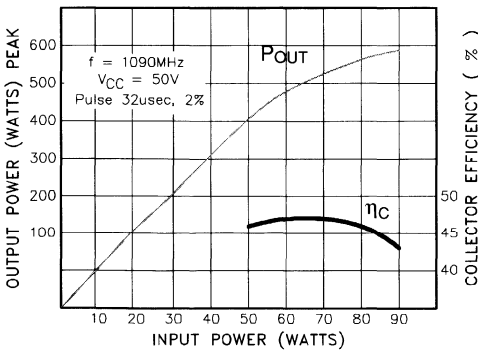
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090MHz$	$P_{IN} = 70W$	$V_{CC} = 50V$	500	—	—	W
$\eta_C$	$f = 1090MHz$	$P_{IN} = 70W$	$V_{CC} = 50V$	40	—	—	%
GP	$f = 1090MHz$	$P_{IN} = 70W$	$V_{CC} = 50V$	8.5	—	—	dB

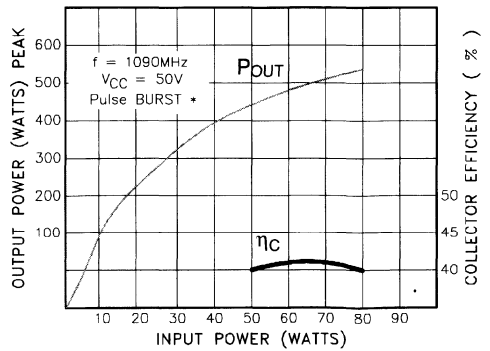
Note: Pulse Width = 32 $\mu$ Sec  
Duty Cycle = 2%

TYPICAL PERFORMANCE

POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT



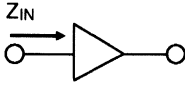
POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT



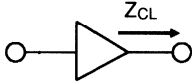
\* Pulse Burst conditions:  
128  $\mu$ Sec train of 0.5  $\mu$ Sec off with a period of 6.4 ms.

IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCE



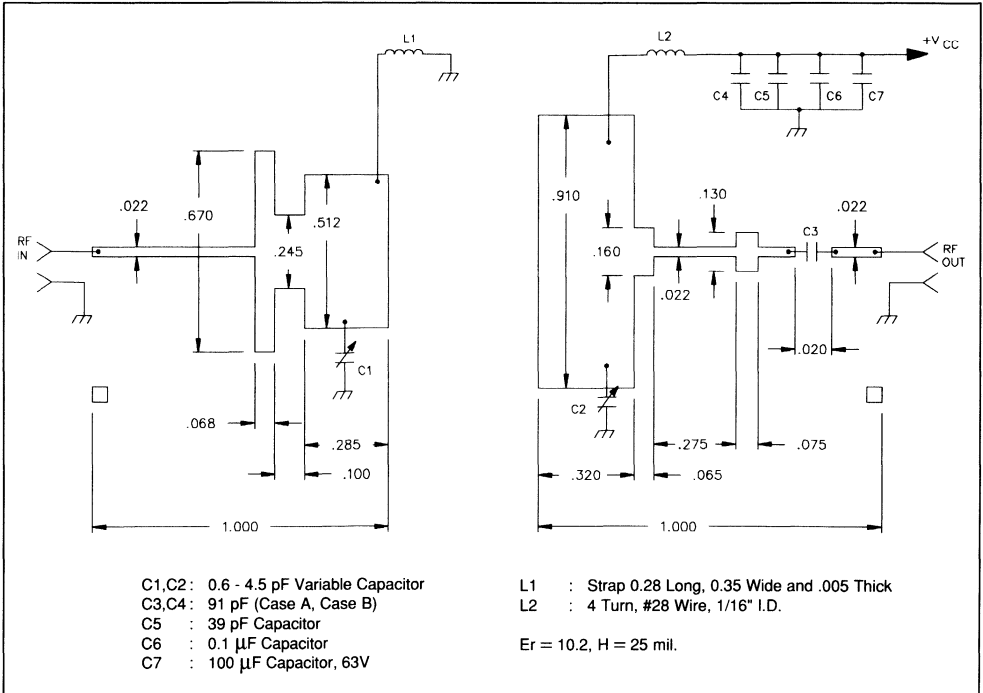
TYPICAL COLLECTOR  
LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1090 MHz	1.24 + j 0.51	1.18 - j 0.73

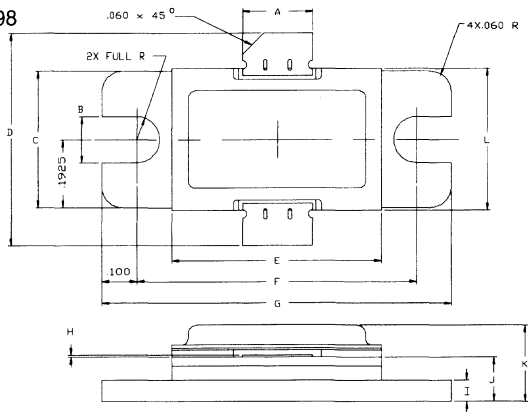
P<sub>IN</sub> = 70W  
V<sub>CC</sub> = 50V  
Normalized to 50 ohms

TEST CIRCUIT (Preliminary)



PACKAGE MECHANICAL DATA

Ref.: Dwg. No. 12-0198



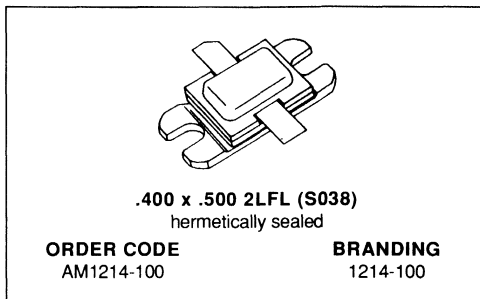
SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.195/4,95	.205/5,21	K		.230/5,84
B	.130/3,30		L	.393/9,98	.410/10,41
C	.380/9,65	.390/9,91			
D	.570/14,48				
E	.590/14,99	.610/15,49			
F	.795/20,19	.805/20,45			
G	.995/25,27	1.005/25,53			
H	.002/0,05	.006/0,15			
I	.055/1,40	.065/1,65			
J	.110/2,79	.130/3,30			



**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

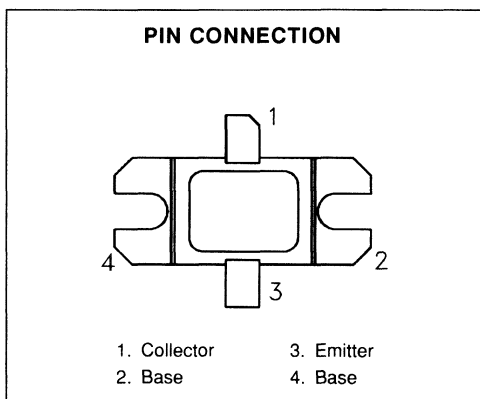
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 100$  W MIN. WITH 6.0 dB GAIN


**DESCRIPTION**

The AM1214-100 device is a high power Class C transistor specifically designed for L-Band Radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 3:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

AM1214-100 is supplied in the grounded IMPAC™ hermetic metal/ceramic package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	270	W
$I_c$	Device Current*	13.5	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.55	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

# AM1214-100

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

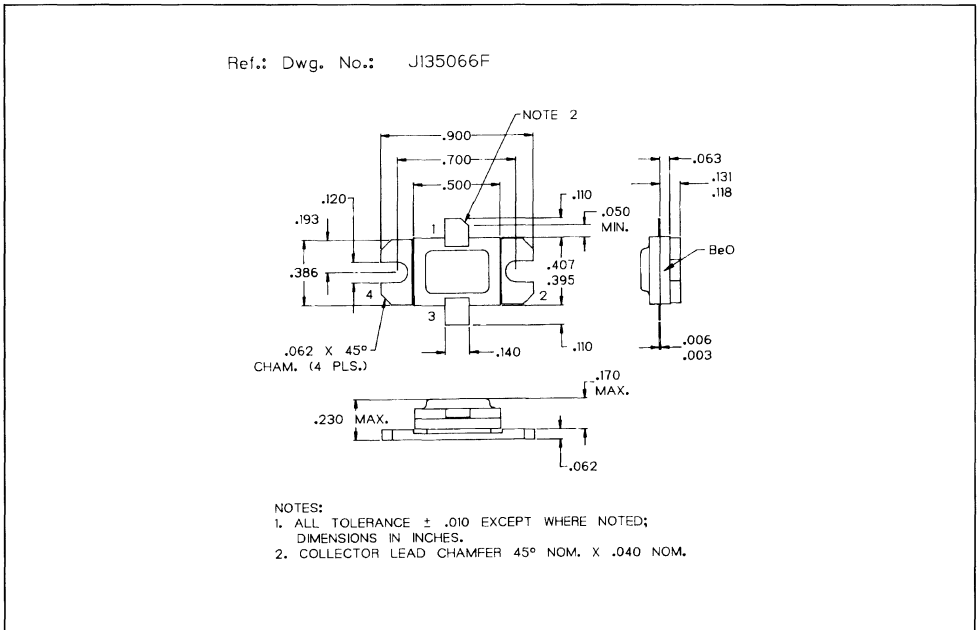
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 100mA		65	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 32V	—	—	20	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 5A	15	—	—	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1215 — 1400MHZ	P <sub>IN</sub> = 25W	V <sub>CC</sub> = 28V	100	—	—	W
η <sub>C</sub>	f = 1215 — 1400MHZ	P <sub>IN</sub> = 25W	V <sub>CC</sub> = 28V	50	—	—	%
G <sub>P</sub>	f = 1215 — 1400MHZ	P <sub>IN</sub> = 25W	V <sub>CC</sub> = 28V	6.0	—	—	dB

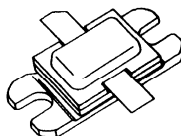
Note: Pulse Width = 100μSec  
Duty Cycle = 10%

## PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 160$  W MIN. WITH 7.3 dB GAIN



**.400 x .500 2LFL (S038)**  
 hermetically sealed

**ORDER CODE**  
 AM1214-175

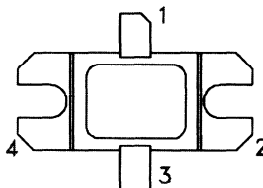
**BRANDING**  
 1214-175

**DESCRIPTION**

The AM1214-175 device is a high power Class C transistor specifically designed for L-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding 3:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1214-175 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	330	W
$I_C$	Device Current*	14	A
$V_{CC}$	Collector-Supply Voltage*	45	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.45	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 60mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 100mA$		65	—	—	V
$I_{CES}$	$V_{CE} = 40V$		—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	15	—	150	—

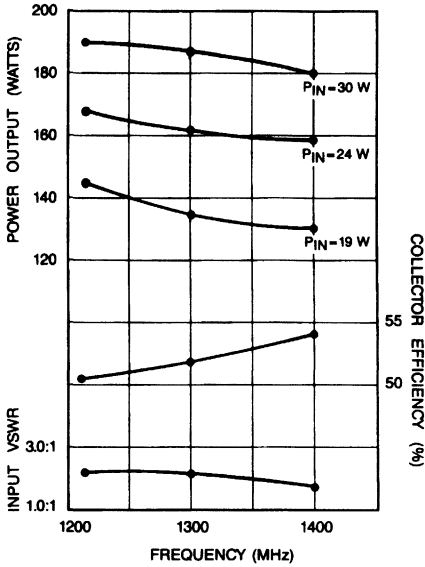
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1215 - 1400MHz$	$P_{IN} = 30W$	$V_{CC} = 40V$	160	180	—	W
$\eta_C$	$f = 1215 - 1400MHz$	$P_{IN} = 30W$	$V_{CC} = 40V$	45	50	—	%
$G_P$	$f = 1215 - 1400MHz$	$P_{IN} = 30W$	$V_{CC} = 40V$	7.3	7.8	—	dB

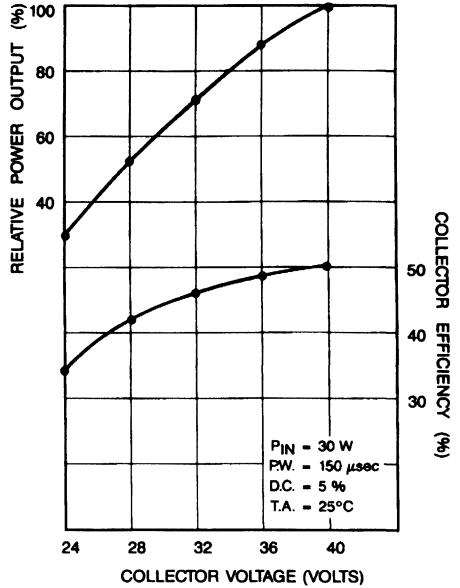
Note: Pulse Width =  $150\mu S$   
 Duty Cycle = 5%

TYPICAL PERFORMANCE

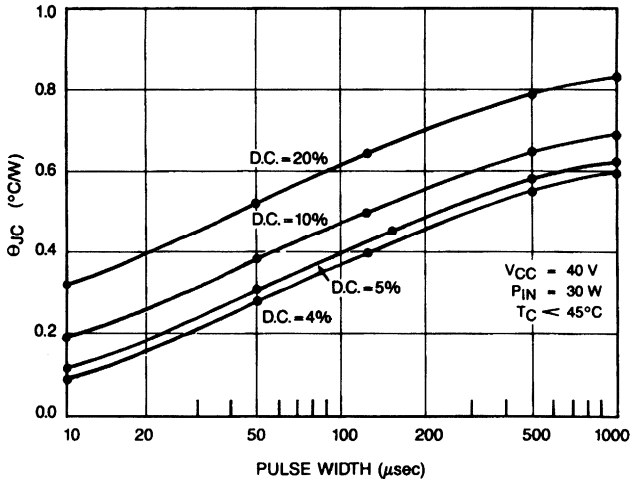
TYPICAL BROADBAND POWER AMPLIFIER



RELATIVE POWER OUTPUT AND COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE

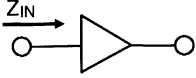


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

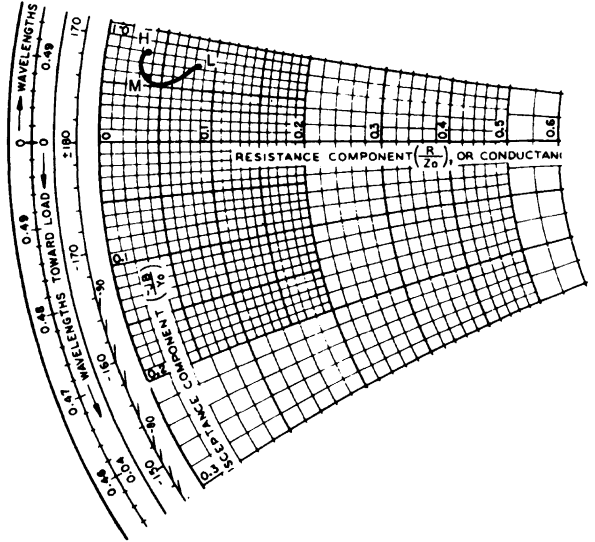


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

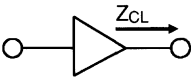


$P_{IN} = 30\text{ W}$   
 $V_{CC} = 40\text{ V}$   
 $Z_0^* = 50\text{ ohms}$

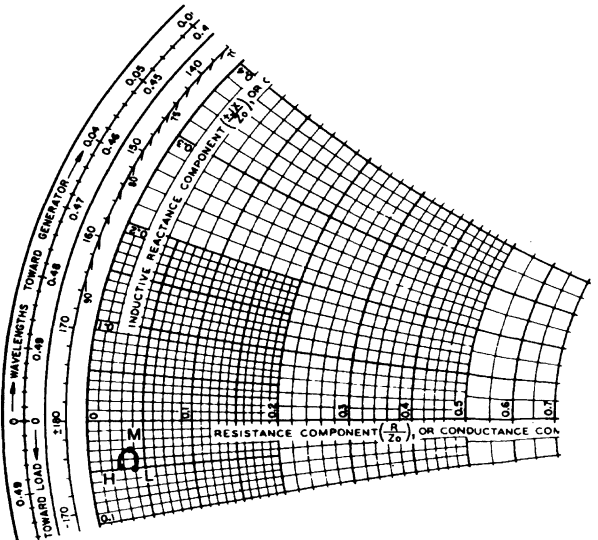


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1215 MHz	$4.0 + j 3.5$	$2.0 - j 2.5$
M = 1300 MHz	$2.0 + j 3.0$	$2.0 - j 1.5$
H = 1400 MHz	$1.5 + j 4.0$	$1.5 - j 2.5$

TYPICAL COLLECTOR LOAD IMPEDANCE

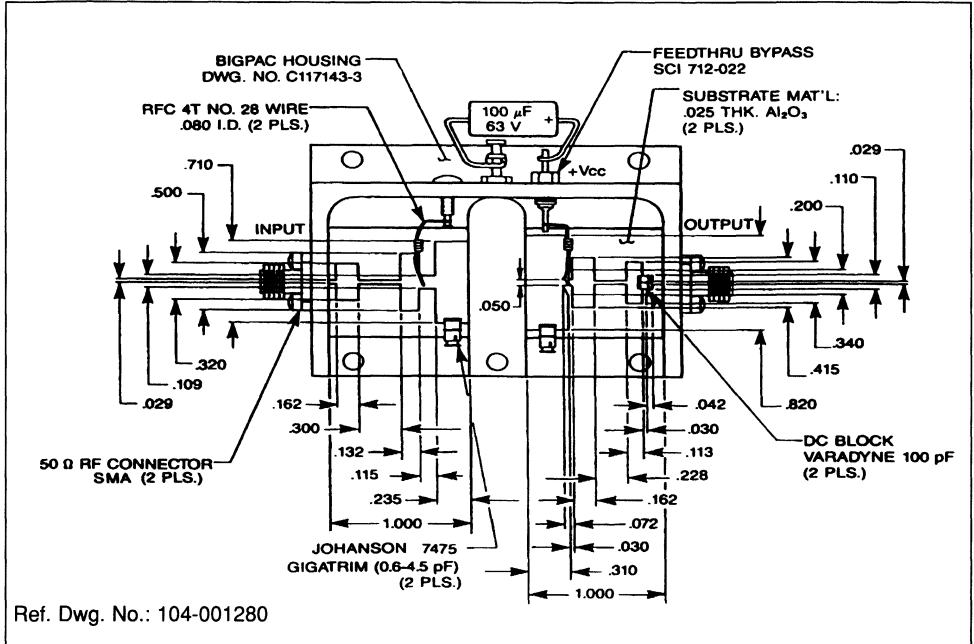


$P_{IN} = 30\text{ W}$   
 $V_{CC} = 40\text{ V}$   
 $Z_0^* = 50\text{ ohms}$

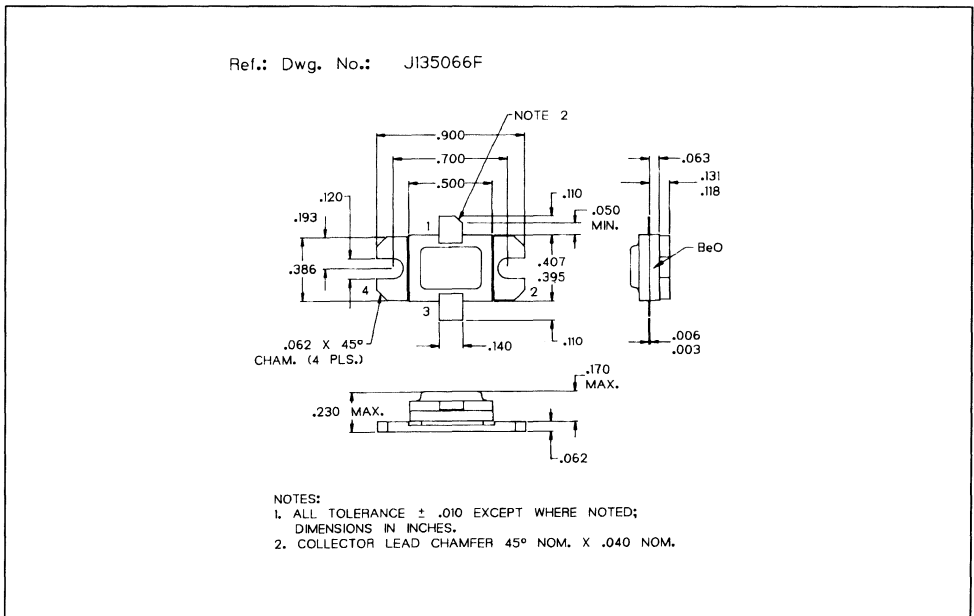


\*Normalized Impedance

TEST CIRCUIT



PACKAGE MECHANICAL DATA



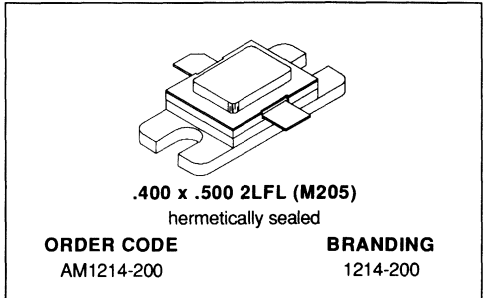




## RF & MICROWAVE TRANSISTORS L-BAND RADAR APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 200$  W MIN. WITH 7.0 dB GAIN

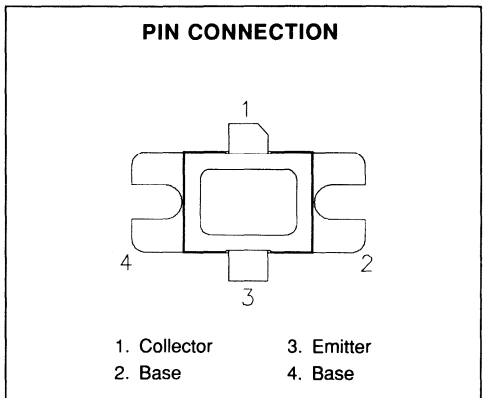


### DESCRIPTION

The AM1214-200 device is a high power Class C transistor specifically designed for L-Band Radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures, and will tolerate severe mismatch and overdrive conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

AM1214-200 is supplied in the BIGPAC™ hermetic metal/ceramic package with internal input/output matching structures.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	575	W
$I_C$	Device Current*	16	A
$V_{CC}$	Collector-Supply Voltage*	40	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.26	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	70	—	—	V
$BV_{EBO}$	$I_E = 30mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	70	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 40V$	—	—	30	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	10	—	—	—

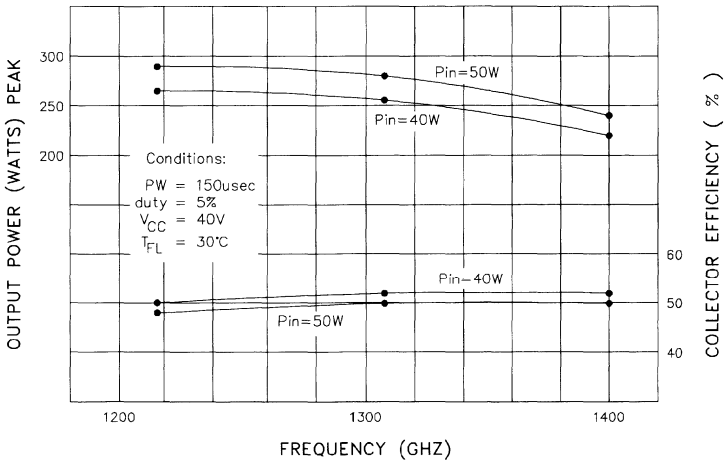
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1215 - 1400MHz$	$P_{IN} = 40W$	$V_{CC} = 40V$	200	—	—	W
$\eta_c$	$f = 1215 - 1400MHz$	$P_{IN} = 40W$	$V_{CC} = 40V$	45	—	—	%
$G_P$	$f = 1215 - 1400MHz$	$P_{IN} = 40W$	$V_{CC} = 40V$	7.0	—	—	dB

Note: Pulse Width = 150 $\mu$ Sec  
 Duty Cycle = 5%

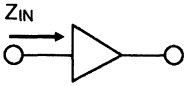
**TYPICAL PERFORMANCE**

**POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**

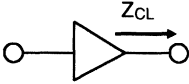


IMPEDANCE DATA

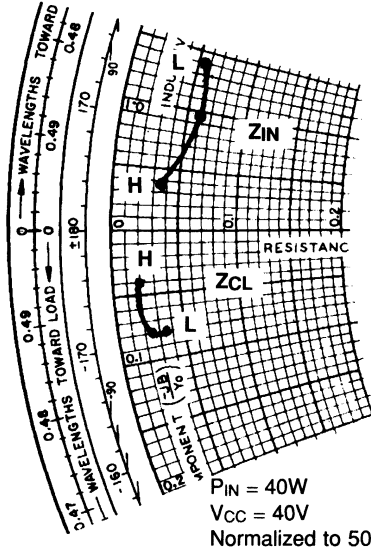
TYPICAL INPUT IMPEDANCE



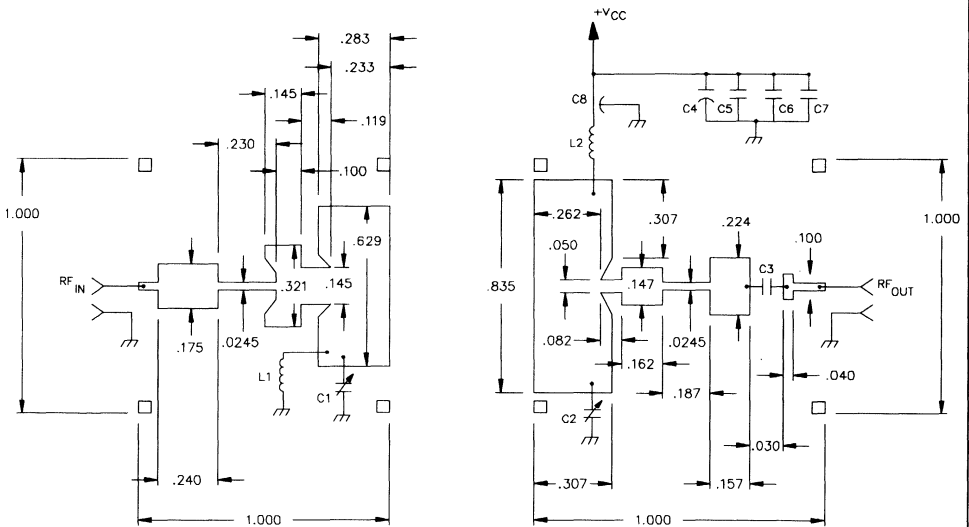
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1215 MHz	2.7 + j 7.0	1.7 - j 4.0
M = 1300 MHz	3.0 + j 4.8	1.4 - j 4.0
H = 1400 MHz	1.8 + j 1.7	1.0 - j 2.0



TEST CIRCUIT

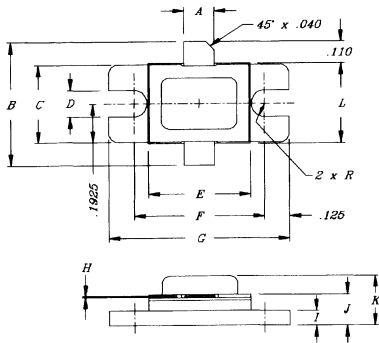


All dimensions are in millimeters.  
Substrate 0.025" Thick AL<sub>2</sub>O<sub>3</sub> (Er = 9.8)

- C1,C2 : 0.6 - 4.5 pF Johanson 7475 Variable Capacitor
- C3 : 100 pF Case B Chip Capacitor
- C4 : 100 μF, 63V Electrolytic Capacitor
- C5 : 68 pF Case B Chip Capacitor

- C6 : 620 pF Case B Chip Capacitor
- C7 : 0.1 μF Ceramic Capacitor
- C8 : Feedthru bypass 1200 pF
- L1 : .018" OD Wire - Placement is Critical
- L2 : 4 Turn .018" OD Inductor

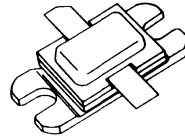
PACKAGE MECHANICAL DATA



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches / mm	MAXIMUM Inches / mm
A	.145 / 3.68	.155 / 3.93
B	.600 / 15.24	
C	.380 / 9.65	.390 / 9.91
D		.130 / 3.30
E	.495 / 12.57	.507 / 12.88
F	.640 / 16.26	.655 / 16.64
G	.890 / 22.61	.910 / 23.11
H	.002 / 0.05	.006 / 0.15
I	.055 / 1.40	.065 / 1.65
J	.115 / 2.92	.135 / 3.43
K		.230 / 5.84
L	.395 / 10.03	.407 / 10.34

## RF & MICROWAVE TRANSISTORS L-BAND RADAR APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 270 W MIN. WITH 6.3 dB GAIN



**.400 x .500 2LFL (S038)**  
hermetically sealed

**ORDER CODE**  
AM1214-300

**BRANDING**  
1214-300

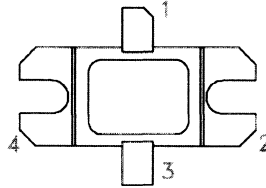
### DESCRIPTION

The AM1214-300 device is a high power transistor specifically designed for L-Band radar pulsed output and driver applications.

This device is designed for operation under moderate pulse width and duty cycle pulse conditions and is capable of withstanding 5:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1214-300 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.

### PIN CONNECTION



- 1. Collector
- 2. Base
- 3. Emitter
- 4. Base

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 100°C)	730	W
I <sub>c</sub>	Device Current*	18.75	A
V <sub>CC</sub>	Collector-Supply Voltage*	55	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.24	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 15mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CES}$	$I_C = 50mA$		65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	30	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	10	—	—	—

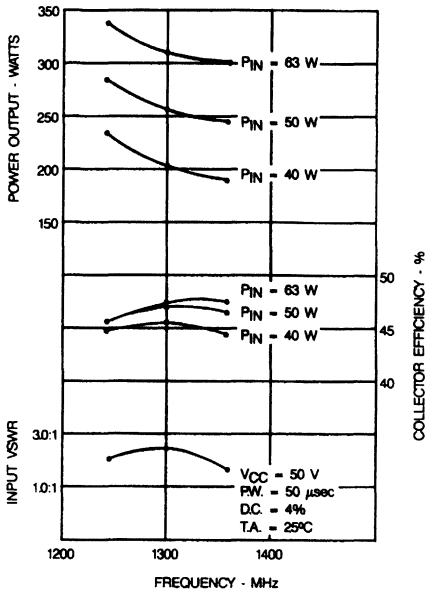
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1235 - 1365MHz$	$P_{IN} = 63W$	$V_{CC} = 50V$	270	300	—	W
$\eta_C$	$f = 1235 - 1365MHz$	$P_{IN} = 63W$	$V_{CC} = 50V$	40	45	—	%
$G_P$	$f = 1235 - 1365MHz$	$P_{IN} = 63W$	$V_{CC} = 50V$	6.3	6.8	—	dB

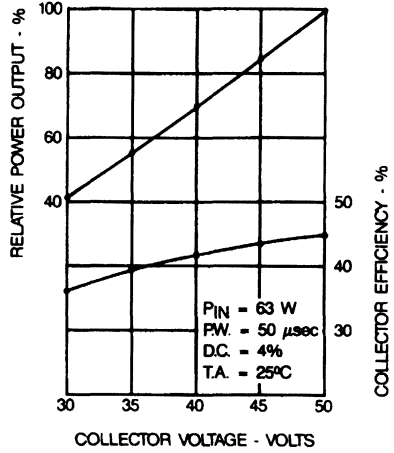
Note: Pulse Width =  $50\mu Sec$   
 Duty Cycle = 4%

TYPICAL PERFORMANCE

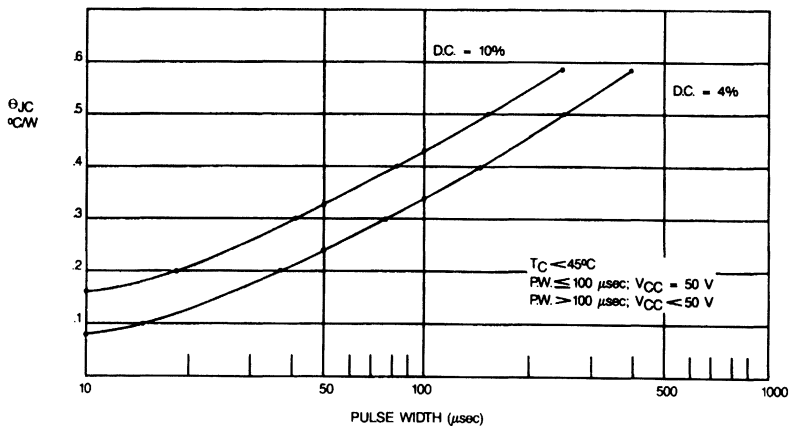
TYPICAL BROADBAND POWER AMPLIFIER



RELATIVE POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE

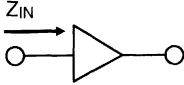


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & PULSE CYCLE

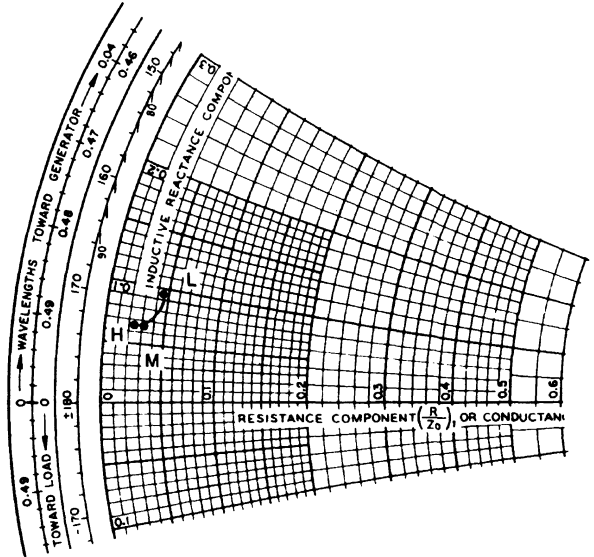


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

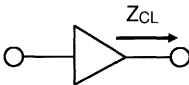


$P_{IN} = 63 \text{ W}$   
 $V_{CC} = 50 \text{ V}$   
 $Z_0^* = 50 \text{ ohms}$

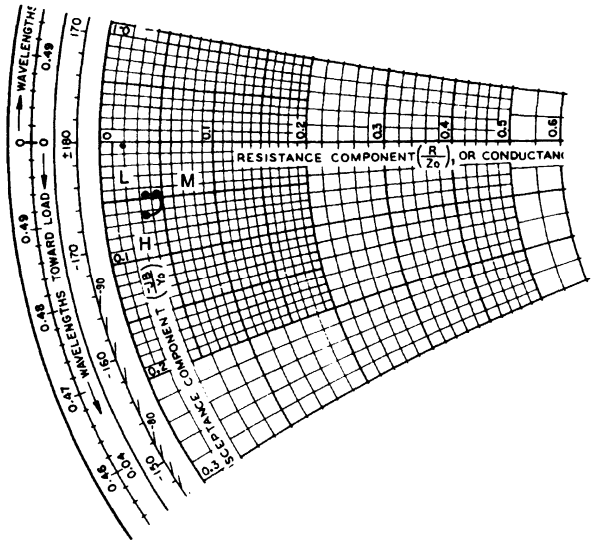


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1235 MHz	$2.5 + j 5.0$	$2.0 - j 2.5$
M = 1300 MHz	$1.5 + j 3.5$	$2.5 - j 2.5$
H = 1365 MHz	$1.0 + j 3.5$	$2.0 - j 3.0$

TYPICAL COLLECTOR LOAD IMPEDANCE



$P_{IN} = 63 \text{ W}$   
 $V_{CC} = 50 \text{ V}$   
 $Z_0^* = 50 \text{ ohms}$

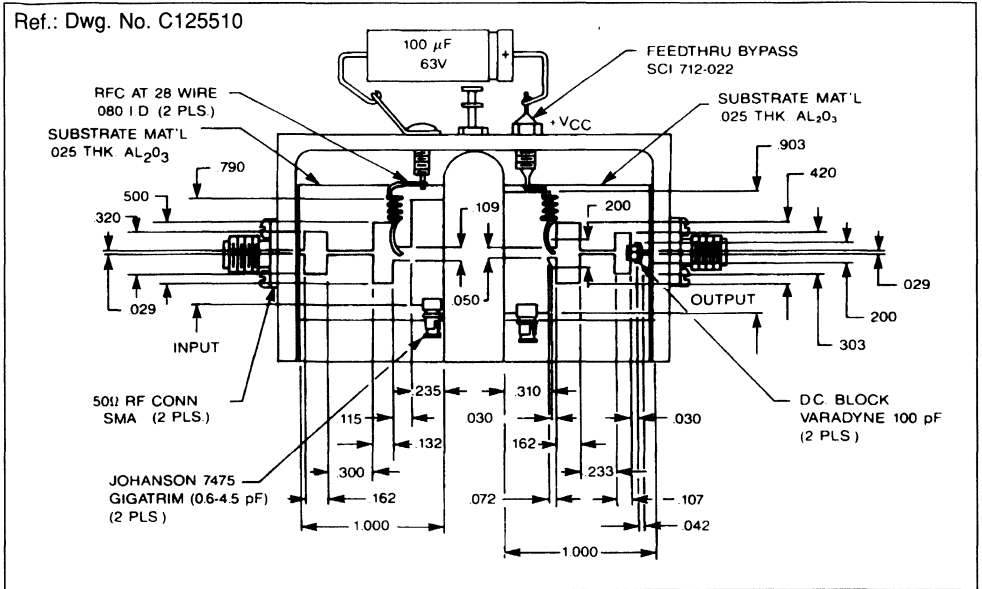


\*Normalized Impedance



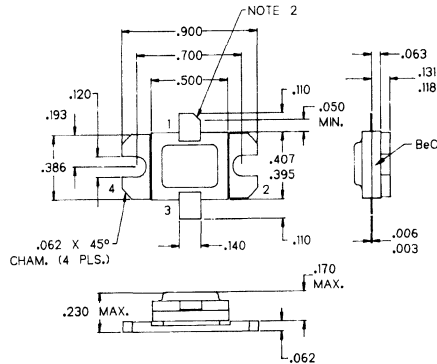
TEST CIRCUIT

Ref.: Dwg. No. C125510



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F



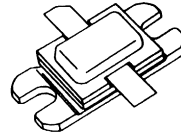
NOTES:

1. ALL TOLERANCE ± .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 325 W MIN. WITH 6.4 dB GAIN



**.400 x .500 2LFL (S038)**  
 hermetically sealed

**ORDER CODE**  
 AM1214-325

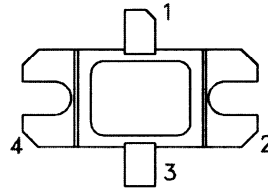
**BRANDING**  
 1214-325

**DESCRIPTION**

The AM1214-325 device is a high power transistor specifically designed for L-Band radar pulsed output and driver applications.

This device is designed for operation under moderate pulse width and duty cycle pulse conditions and is capable of withstanding 5:1 VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1214-325 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	1250	W
I <sub>C</sub>	Device Current*	25	A
V <sub>CC</sub>	Collector-Supply Voltage*	45	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.10	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 15mA	I <sub>C</sub> = 0mA	3.0	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 50mA		65	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 50V		—	—	30	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 5A	10	—	—	—

DYNAMIC

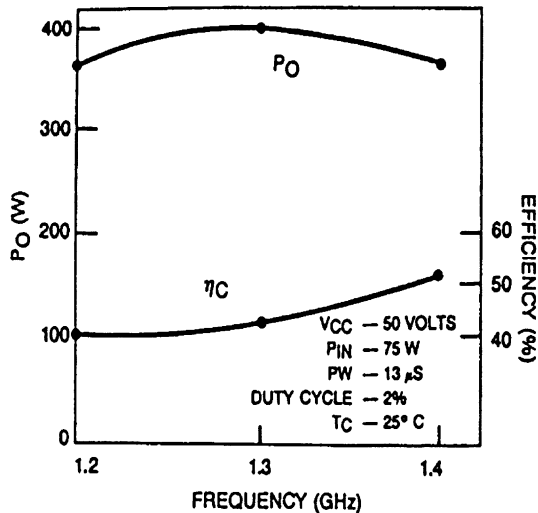
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1200 — 1400MHz	P <sub>IN</sub> = 75W	V <sub>CC</sub> = 45V	325	360	—	W
η <sub>C</sub>	f = 1200 — 1400MHz	P <sub>IN</sub> = 75W	V <sub>CC</sub> = 45V	38	45	—	%
G <sub>P</sub>	f = 1200 — 1400MHz	P <sub>IN</sub> = 75W	V <sub>CC</sub> = 45V	6.4	6.8	—	dB

Note: Pulse Width = 13μSec

Duty Cycle = 2%

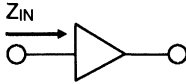
**TYPICAL PERFORMANCE**

**POWER OUTPUT & EFFICIENCY vs FREQUENCY**

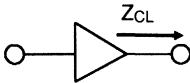


IMPEDANCE DATA

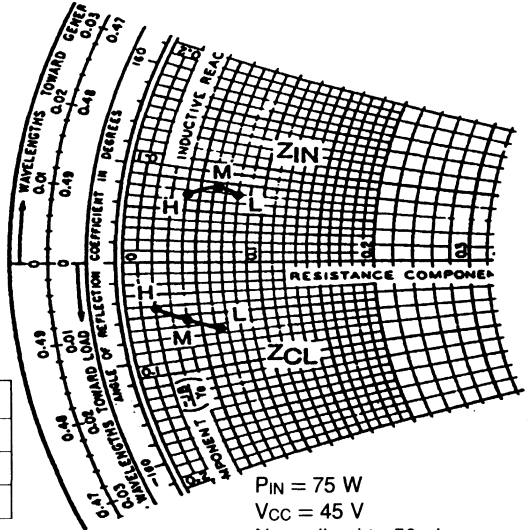
TYPICAL INPUT IMPEDANCE



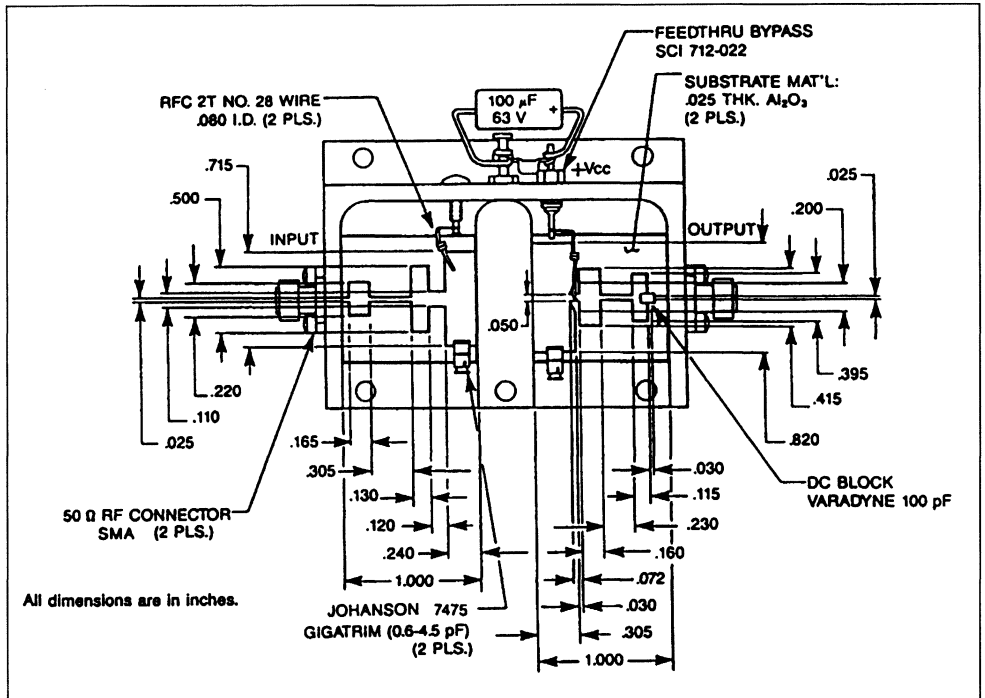
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1.2 GHz	4.0 + j 3.5	3.0 - j 3.0
M = 1.3 GHz	3.0 + j 4.0	2.0 - j 2.5
H = 1.4 GHz	2.0 + j 3.5	1.0 - j 2.0

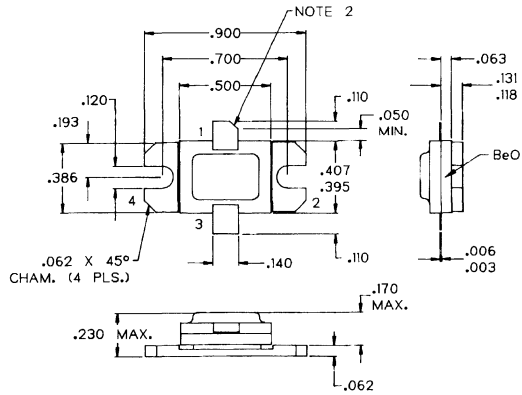


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F



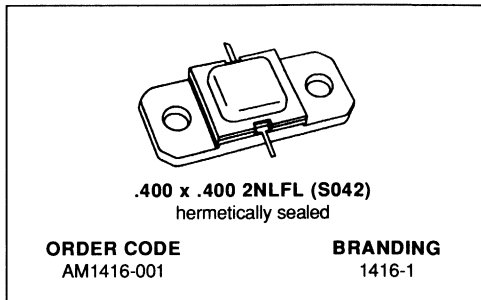
NOTES:

- 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
- 2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

**RF & MICROWAVE TRANSISTORS  
 APPLICATIONS**

PRELIMINARY DATA

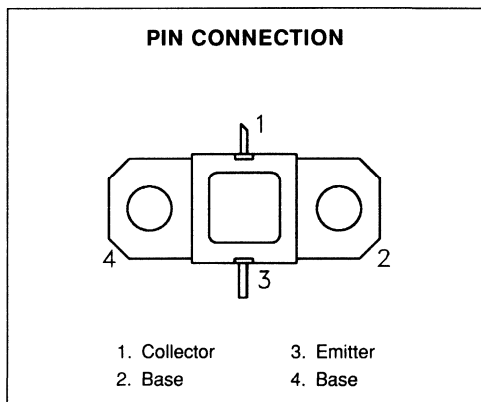
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 1.5 \text{ W MIN. WITH } 8.8 \text{ dB GAIN}$


**DESCRIPTION**

The AM1416-001 is a common base, silicon NPN bipolar device optimized for Class C, CW operation in the 1400 - 1600 MHz frequency range.

AM1416-001 utilizes a rugged, emitter ballasted die geometry to achieve high gain and efficiency and is suitable for driver or output stages in Class C power amplifiers.

The AM1416-001 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 75^{\circ}\text{C}$ )	4.6	W
$I_c$	Device Current*	.213	A
$V_{CC}$	Collector-Supply Voltage*	24	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	22	$^{\circ}\text{C/W}$
---------------	-----------------------------------	----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

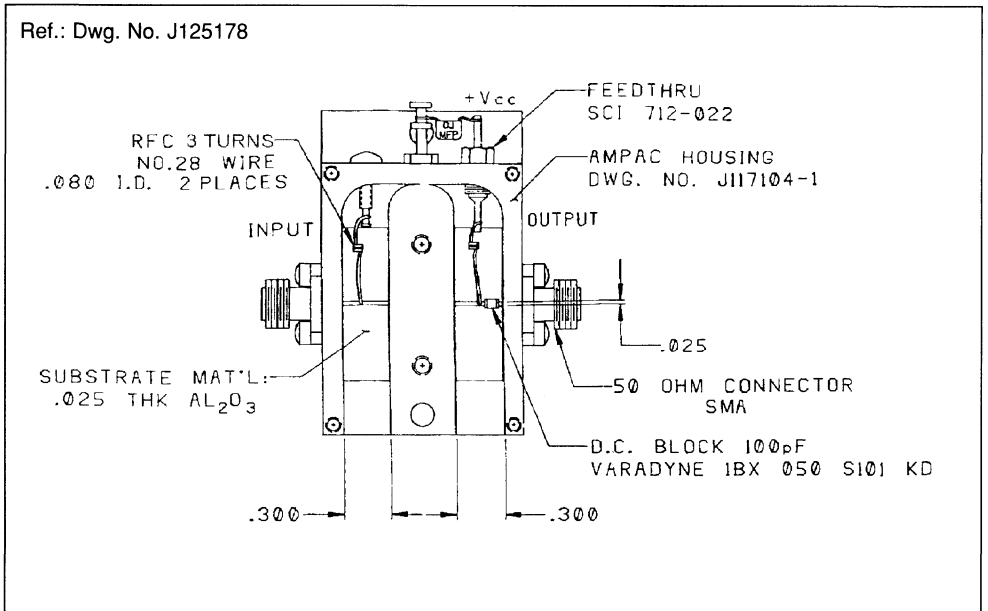
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	40	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 24V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1400 - 1600MHz$	$P_{IN} = 0.20W$	$V_{CC} = 24V$	1.5	—	—	W
$\eta_C$	$f = 1400 - 1600MHz$	$P_{IN} = 0.20W$	$V_{CC} = 24V$	45	—	—	%
GP	$f = 1400 - 1600MHz$	$P_{IN} = 0.20W$	$V_{CC} = 24V$	8.8	—	—	dB

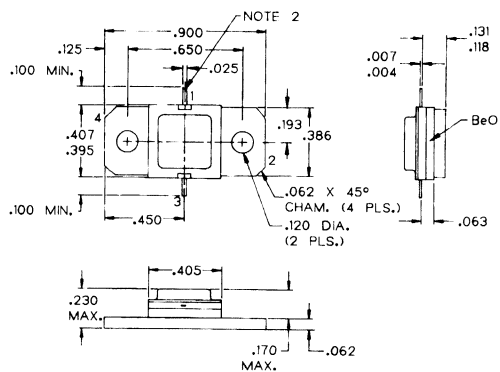
TEST CIRCUIT





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

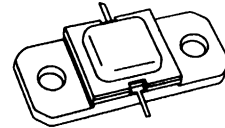
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 APPLICATIONS**

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 3.2 \text{ W MIN. WITH } 8.1 \text{ dB GAIN}$



**.400 x .400 2N1FL (S042)**  
 hermetically sealed

**ORDER CODE**  
 AM1416-003

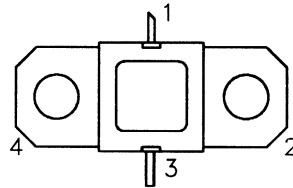
**BRANDING**  
 1416-3

**DESCRIPTION**

The AM1416-003 is a common base, silicon NPN bipolar device optimized for Class C, CW operation in the 1400 - 1600 MHz frequency range.

AM1416-003 utilizes a rugged, emitter ballasted die geometry to achieve high gain and efficiency and is suitable for driver or output stages in Class C power amplifiers.

The AM1416-003 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 40^{\circ}\text{C}$ )	10.6	W
$I_C$	Device Current*	.49	A
$V_{CC}$	Collector-Supply Voltage*	24	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	15	$^{\circ}\text{C/W}$
---------------	-----------------------------------	----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

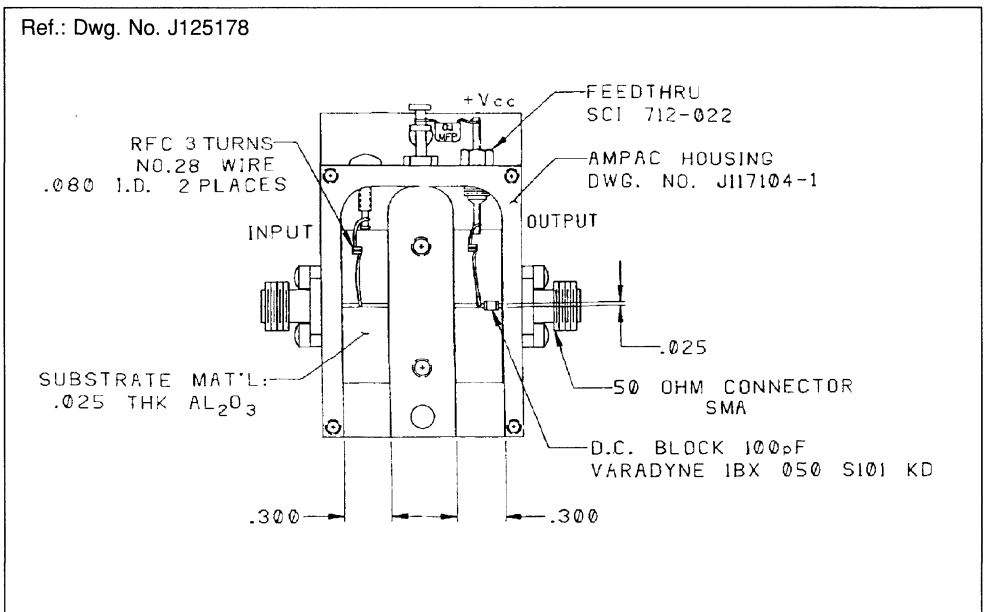
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 1mA	I <sub>E</sub> = 0mA	40	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.0	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 5mA	R <sub>BE</sub> = 10Ω	40	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 24V	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 250mA	15	—	120	—

DYNAMIC

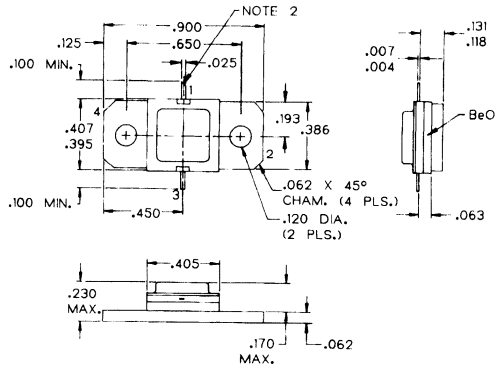
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1400 - 1600MHz	P <sub>IN</sub> = 0.50W	V <sub>CC</sub> = 24V	3.2	—	—	W
η <sub>C</sub>	f = 1400 - 1600MHz	P <sub>IN</sub> = 0.50W	V <sub>CC</sub> = 24V	45	—	—	%
G <sub>P</sub>	f = 1400 - 1600MHz	P <sub>IN</sub> = 0.50W	V <sub>CC</sub> = 24V	8.1	—	—	dB

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



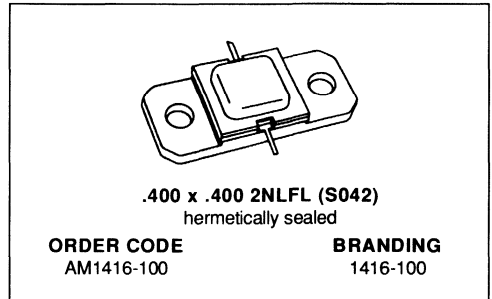
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 APPLICATIONS**

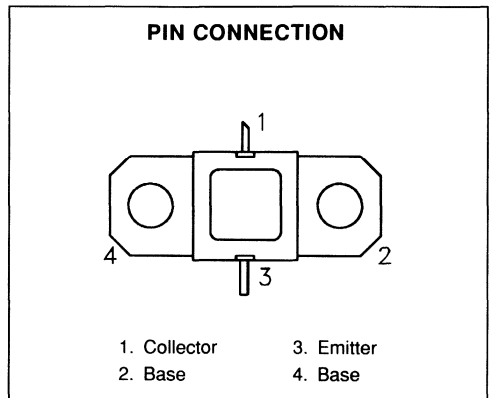
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 90$  W MIN. WITH 7.8 dB GAIN


**DESCRIPTION**

The AM1416-100 device is a high power silicon bipolar NPN transistor specifically designed for L-Band radar pulsed output and driver applications.

The device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures, and can withstand a 3:1 output VSWR with a + 1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM1416-100 is supplied in the hermetic metal/ceramic package with internal input/output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 125^{\circ}C$ )	390	W
$I_C$	Device Current*	8.5	A
$V_{CC}$	Collector-Supply Voltage*	50	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.32	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

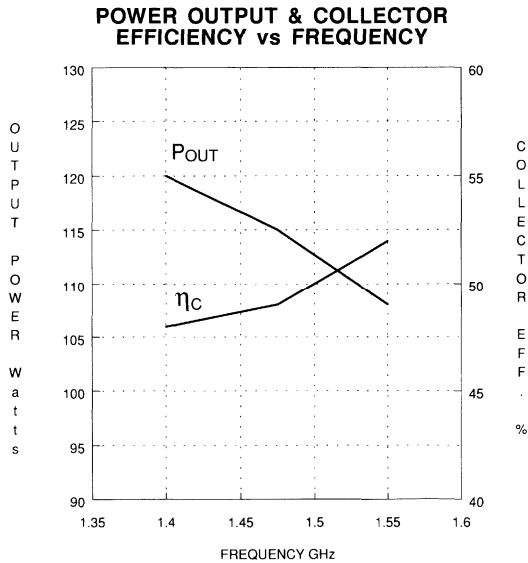
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 60mA$	$I_E = 0mA$	60	—	—	V
$BV_{EBO}$	$I_E = 3mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 60mA$	$V_{BE} = 0V$	60	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 45V$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	—	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1400 - 1550MHz$	$P_{IN} = 15W$	$V_{CC} = 45V$	90	—	—	W
$\eta_C$	$f = 1400 - 1550MHz$	$P_{IN} = 15W$	$V_{CC} = 45V$	40	—	—	%
$G_P$	$f = 1400 - 1550MHz$	$P_{IN} = 15W$	$V_{CC} = 45V$	7.8	—	—	dB

Note: Pulse Width = 10 $\mu$ Sec  
 Duty Cycle = 10%

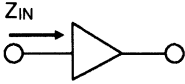
**TYPICAL PERFORMANCE**



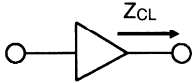


IMPEDANCE DATA

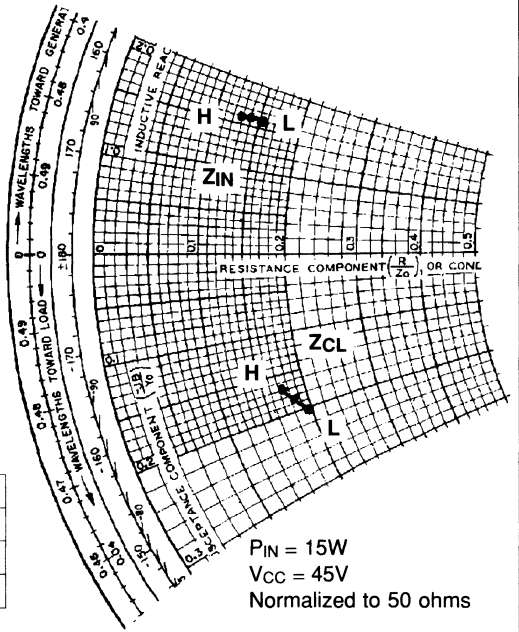
TYPICAL INPUT IMPEDANCE



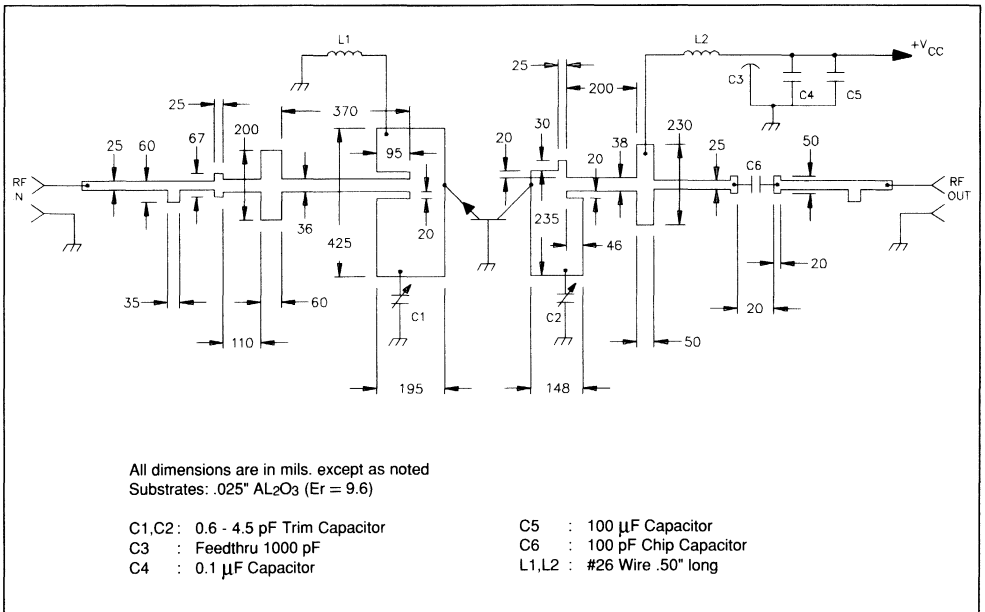
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1.4 GHz	7.5 + j 8.0	9.6 - j 10.0
M = 1.475 GHz	7.0 + j 8.0	9.2 - j 9.2
H = 1.55 GHz	6.4 + j 8.0	8.8 - j 8.5

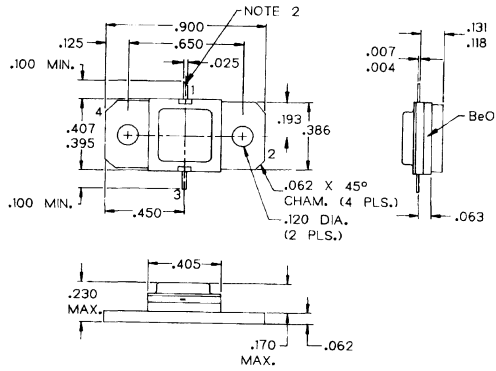


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



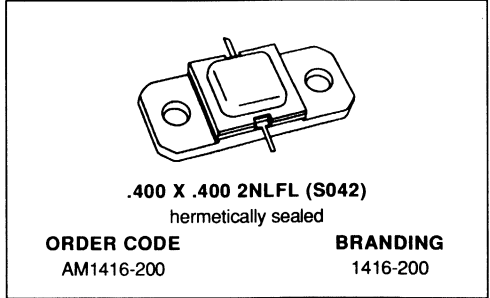
NOTES:

1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.

**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

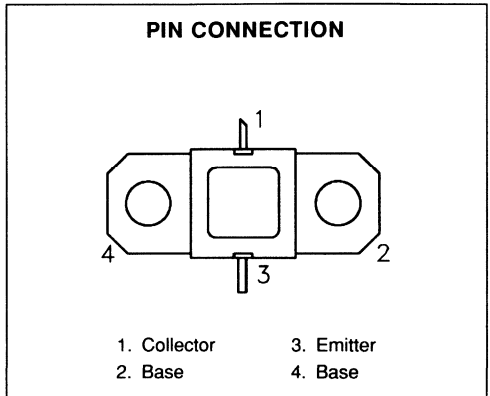
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 180 \text{ W MIN. WITH } 6.5 \text{ dB GAIN}$


**DESCRIPTION**

The AM1416-200 device is a high power silicon bipolar NPN transistor specifically designed for L-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and can withstand a 3:1 output VSWR with a + 1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM1416-200 is supplied in the hermetic metal/ceramic package with internal input/output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 125^{\circ}\text{C}$ )	625	W
$I_C$	Device Current*	12	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.2	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

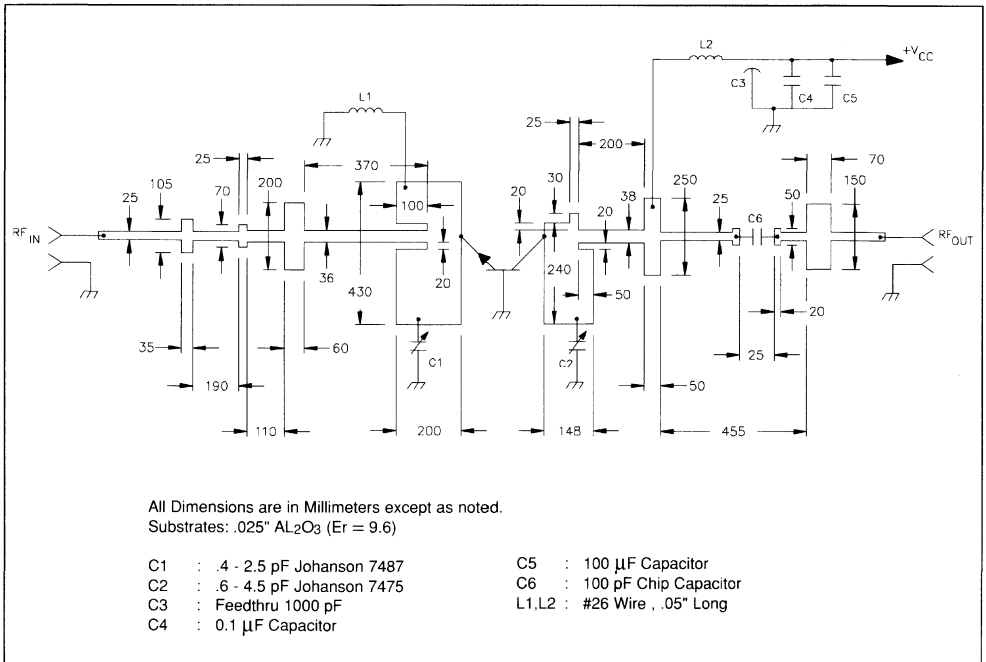
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 25mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 25mA	R <sub>BE</sub> = 10Ω	65	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 50V	—	—	15	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 2.5A	10	—	—	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1400 — 1550MHz	P <sub>IN</sub> = 40W	V <sub>CC</sub> = 50V	180	—	—	W
η <sub>c</sub>	f = 1400 — 1550MHz	P <sub>IN</sub> = 40W	V <sub>CC</sub> = 50V	40	—	—	%
G <sub>P</sub>	f = 1400 — 1550MHz	P <sub>IN</sub> = 40W	V <sub>CC</sub> = 50V	6.5	—	—	dB

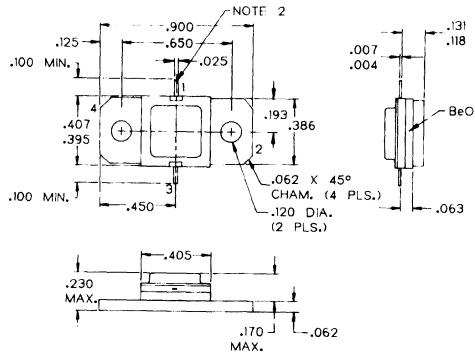
Note: Pulse Width = 10μSec  
 Duty Cycle = 10%

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



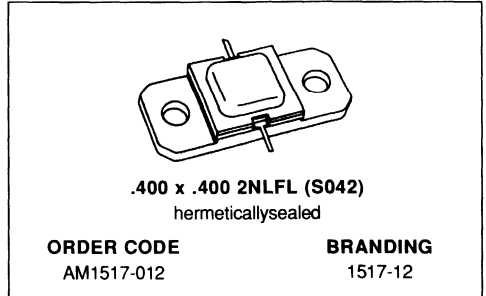
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



## RF & MICROWAVE TRANSISTORS SATELLITE COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty:1$  VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 12$  W MIN. WITH 8.5 dB GAIN

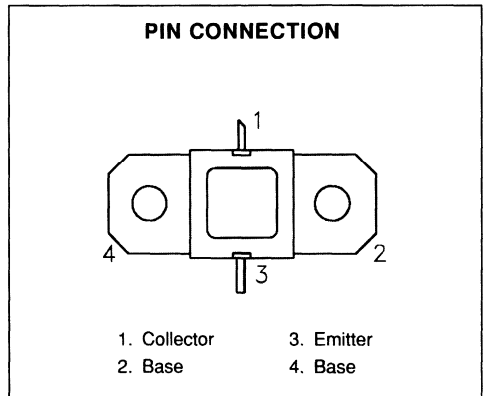


### DESCRIPTION

The AM1517-012 power transistor is designed specifically for Satellite communications applications in the 1.5 – 1.7 GHz frequency range.

The device is capable of withstanding any mismatch load condition at any phase angle (VSWR  $\infty:1$ ) under full rated conditions. The unit is an overlay, emitter site ballasted, geometry utilizing a Refractory/Gold metallization system.

The AM1517-012 is supplied in the AMPAC™ Hermetic/Ceramic package with internal Input/Output matching structures.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	27	W
$I_c$	Device Current*	1.25	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	5.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** (Tcase = 25°C)

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 4mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 4mA	I <sub>C</sub> = 0mA	3.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = .8A	15	—	150	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1.5 — 1.7GHz	P <sub>IN</sub> = 1.7W	V <sub>CC</sub> = 28V	12	13	—	W
η <sub>C</sub>	f = 1.5 — 1.7GHz	P <sub>IN</sub> = 1.7W	V <sub>CC</sub> = 28V	55	58	—	%
G <sub>P</sub>	f = 1.5 — 1.7GHz	P <sub>IN</sub> = 1.7W	V <sub>CC</sub> = 28V	8.5	—	—	dB

Note: AM1517 series vary P<sub>IN</sub> to achieve P<sub>OUT</sub>; performance guaranteed in 50 MHz increments.  
 Alpha-Suffix added to AM1517 P/N designates band segment.

A -1500 = 1550 MHz

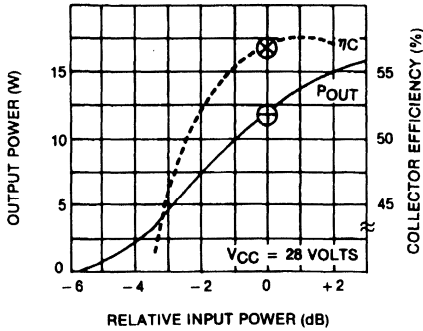
M -1620 = 1660 MHz

S -1625 = 1675 MHz

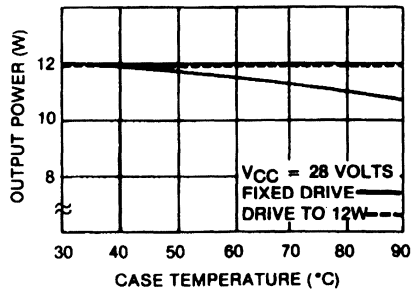


TYPICAL PERFORMANCE

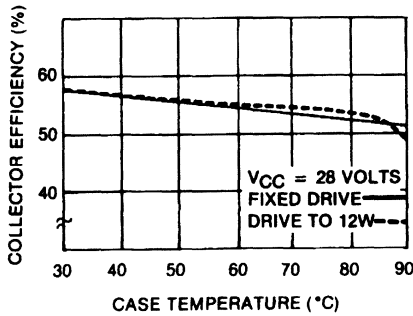
TYPICAL PERFORMANCE vs DRIVE POWER



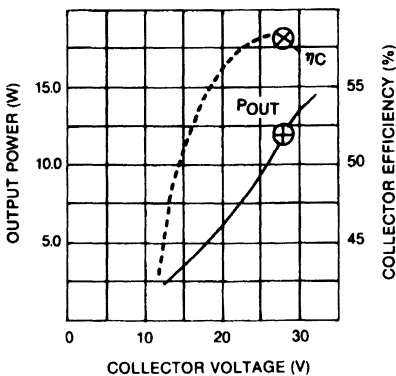
POWER OUTPUT vs TEMPERATURE



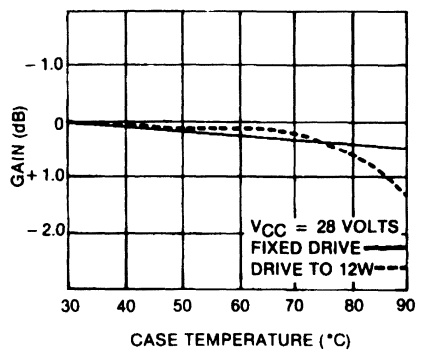
COLLECTOR EFFICIENCY vs TEMPERATURE



TYPICAL PERFORMANCE vs VOLTAGE @ FIXED DRIVE

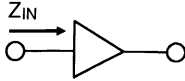


GAIN vs TEMPERATURE

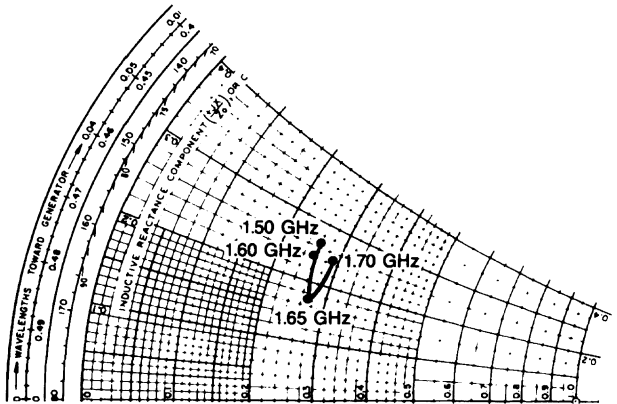


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

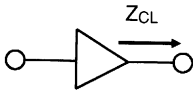


$P_{OUT} = 12\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 $Z_O = 50\text{ ohms}$

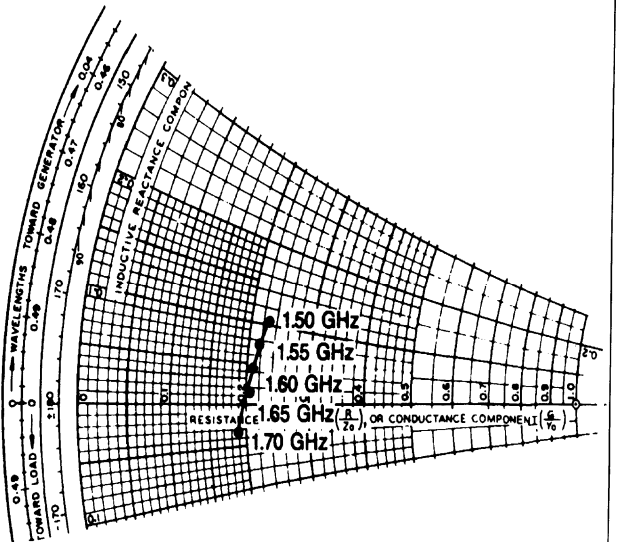


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1.50 GHz	$13.0 + j 13.5$	$11.5 + j 5.0$
M = 1.60 GHz	$13.0 + j 12.0$	$10.5 + j 2.2$
H = 1.70 GHz	$14.5 + j 12.5$	$9.5 - j 1.5$

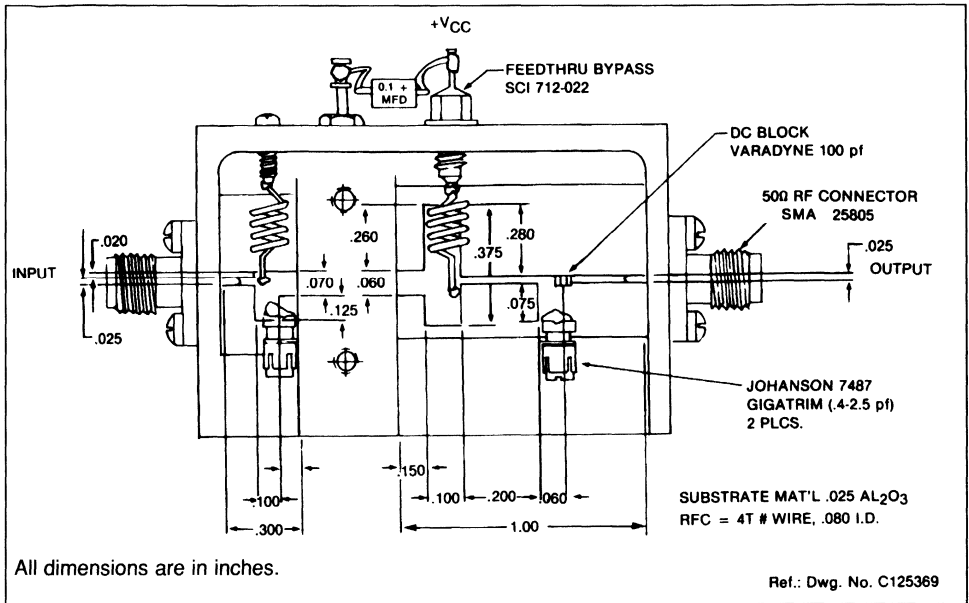
TYPICAL COLLECTOR LOAD IMPEDANCE



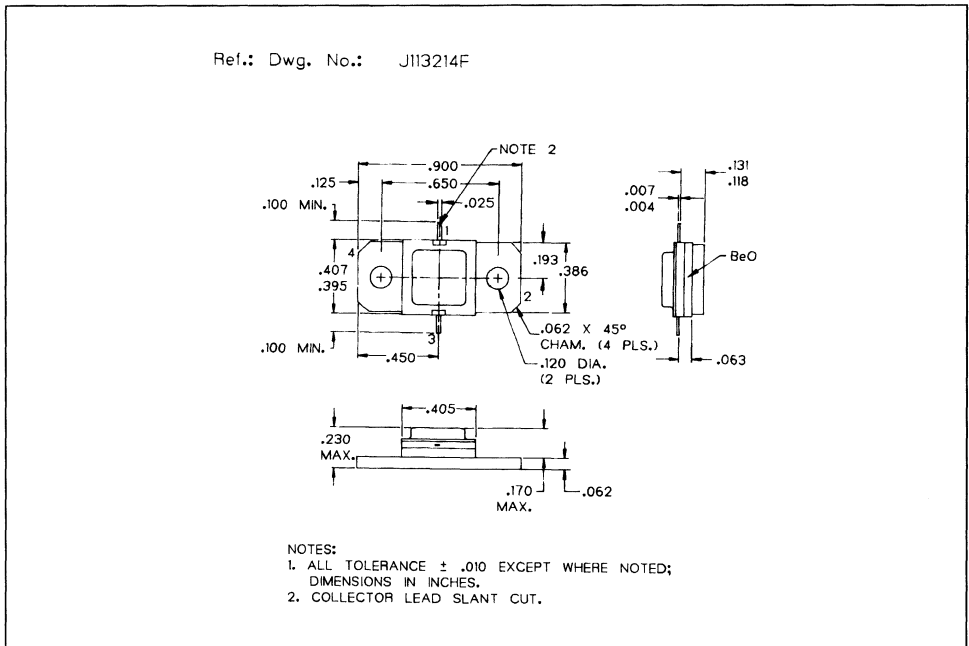
$P_{OUT} = 12\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 $Z_O = 50\text{ ohms}$



TEST CIRCUIT



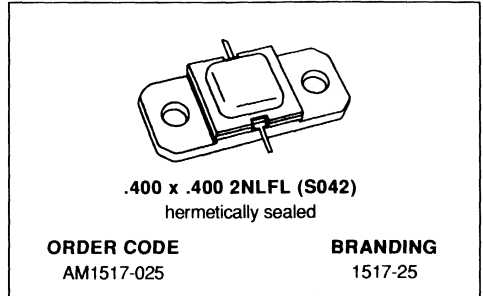
PACKAGE MECHANICAL DATA





## RF & MICROWAVE TRANSISTORS SATELLITE COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty:1$  VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 25$  W MIN. WITH 8.5 dB GAIN

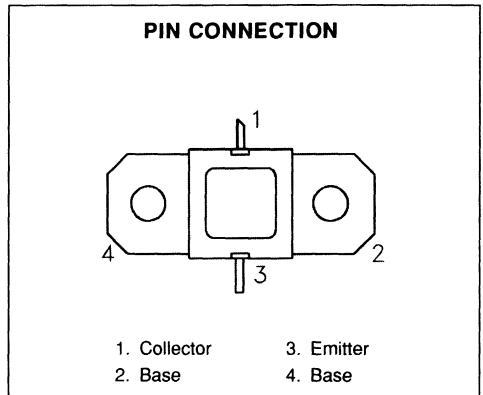


### DESCRIPTION

The AM1517-025 power transistor is designed specifically for Satellite communications applications in the 1.5 – 1.7 GHz frequency range.

The device is capable of withstanding any mismatch load condition at any phase angle (VSWR  $\infty:1$ ) under full rated conditions. The unit is an overlay, emitter site ballasted, geometry utilizing a Refractory/Gold metallization system.

The AM1517-025 is supplied in the AMPACT™ Hermetic/Ceramic package with internal Input/Output matching structures.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	45	W
$I_C$	Device Current*	2.5	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	3.3	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 8mA$	$I_E = 0mA$	45	—	—	V	
$BV_{EBO}$	$I_E = 8mA$	$I_C = 0mA$	3.0	—	—	V	
$I_{CBO}$	$V_{CB} = 28V$		—	—	2	mA	
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1.6A$	15	—	150	—	

**DYNAMIC**

Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.5 - 1.7GHz$	$P_{IN} = 3.5W$	$V_{CC} = 28V$	25	—	—	W	
$\eta_C$	$f = 1.5 - 1.7GHz$	$P_{IN} = 3.5W$	$V_{CC} = 28V$	55	58	—	%	
$G_P$	$f = 1.5 - 1.7GHz$	$P_{IN} = 3.5W$	$V_{CC} = 28V$	8.5	—	—	dB	

Note: AM1517 series vary  $P_{IN}$  to achieve  $P_{OUT}$ ; performance guaranteed in 50 MHz increments.

Alpha-Suffix added to AM1517 P/N designates band segment.

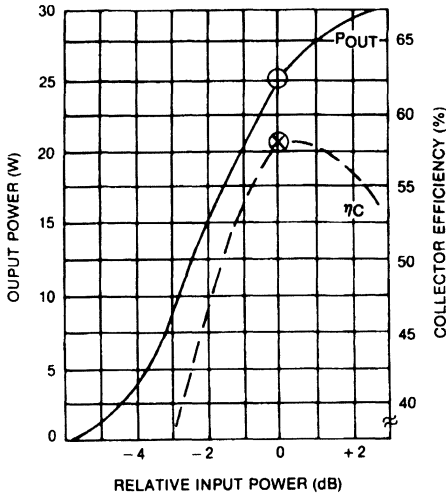
A -1500 - 1550 MHz

M -1620 - 1660 MHz

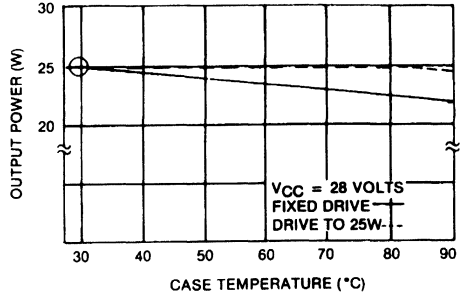
S -1625 - 1675 MHz

TYPICAL PERFORMANCE

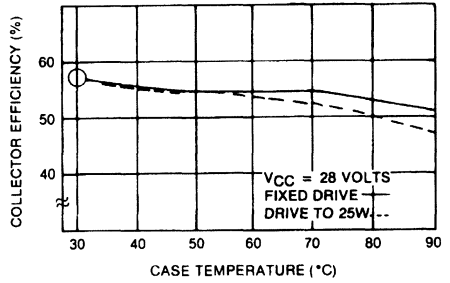
**POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**



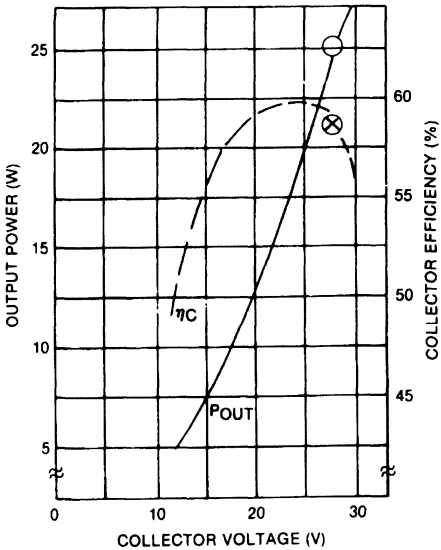
**POWER OUTPUT vs TEMPERATURE**



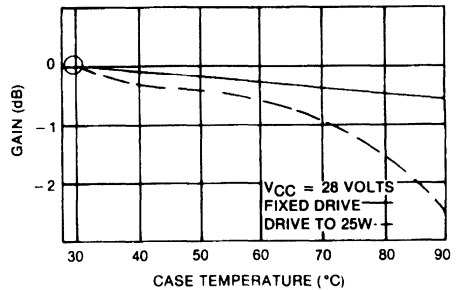
**COLLECTOR EFFICIENCY vs TEMPERATURE**



**POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE**

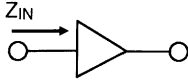


**GAIN vs TEMPERATURE**

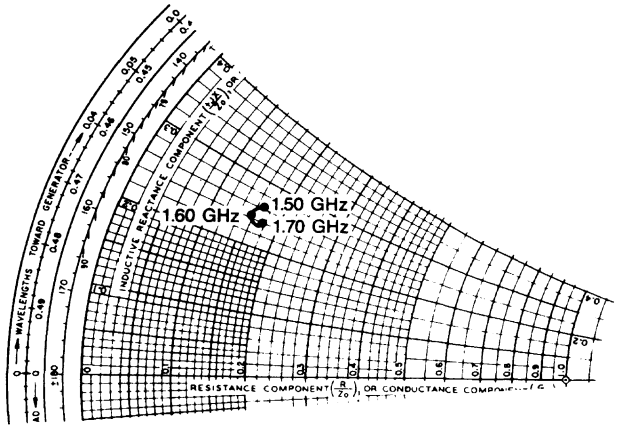


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

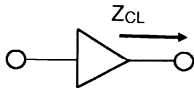


$P_{OUT} = 25\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 $Z_O = 50\text{ ohms}$

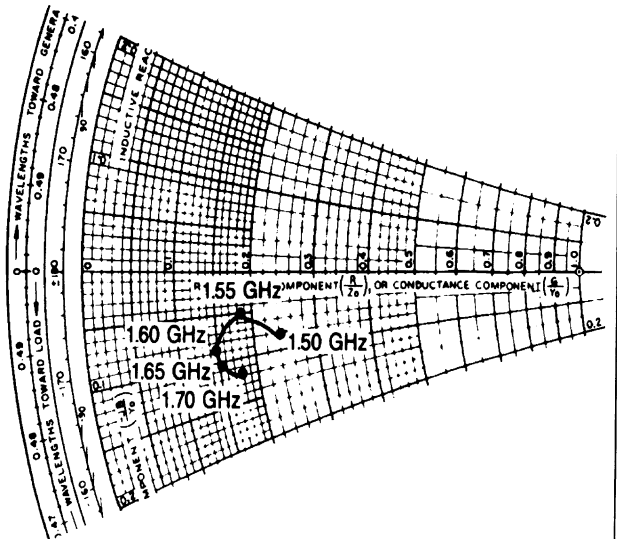


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1.5 GHz	$8.5 + j 13.0$	$12.0 - j 4.0$
M = 1.6 GHz	$8.0 + j 12.5$	$7.5 - j 4.5$
H = 1.7 GHz	$9.0 + j 12.0$	$9.0 - j 6.0$

TYPICAL COLLECTOR LOAD IMPEDANCE

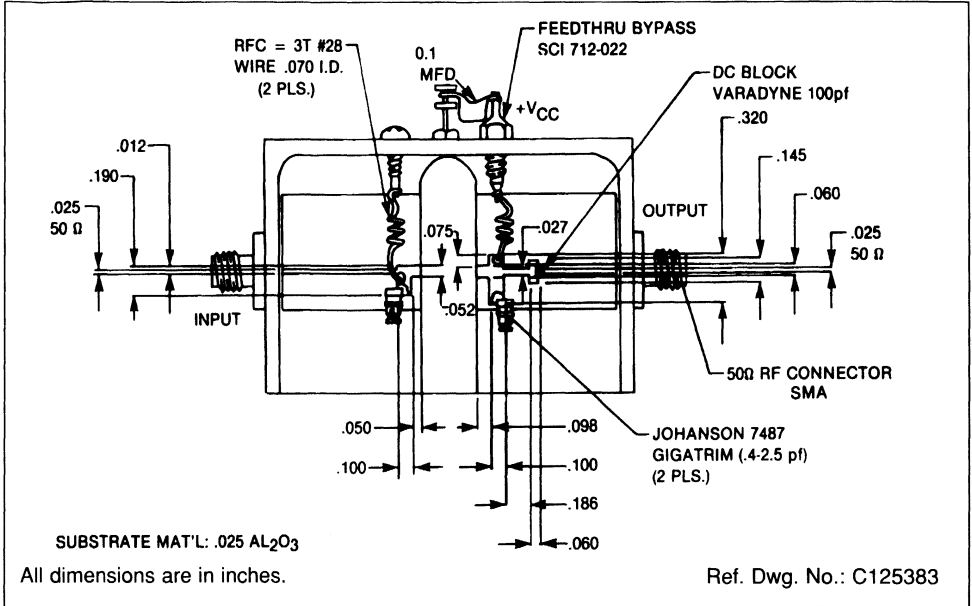


$P_{OUT} = 25\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 $Z_O = 50\text{ ohms}$

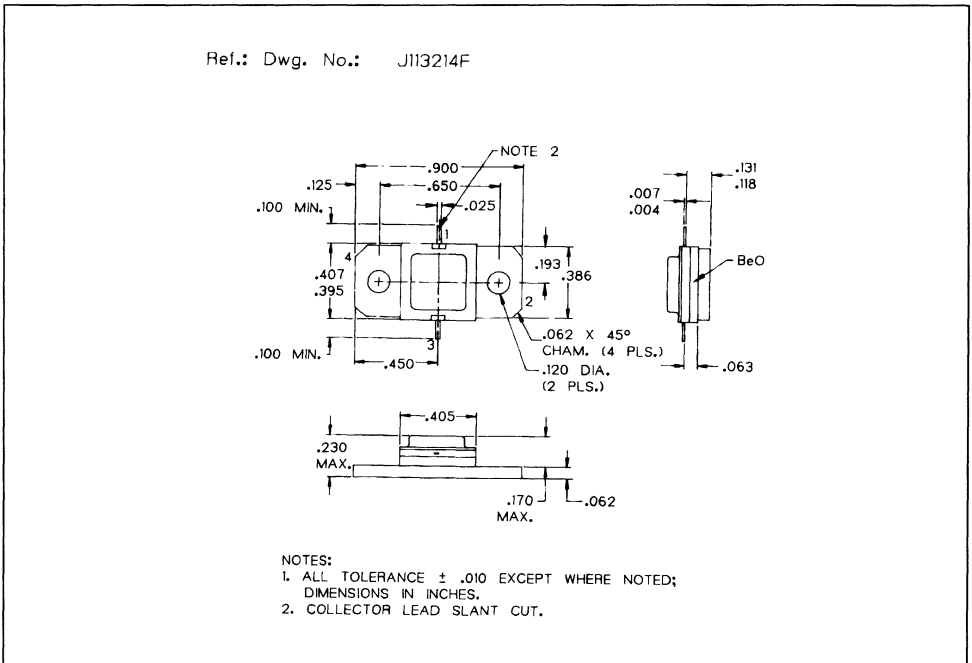




TEST CIRCUIT



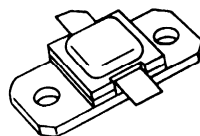
PACKAGE MECHANICAL DATA





## RF & MICROWAVE TRANSISTORS SATELLITE COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty$ :1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 35$  W MIN. WITH 7.0 dB GAIN



**.400 x .400 2LFL (S036)**  
hermetically sealed

**ORDER CODE**

AM1517-035

**BRANDING**

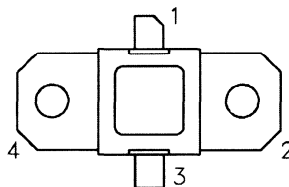
1517-35

### DESCRIPTION

The AM1517-035 is a high power, CW transistor specifically designed to operate within a 50 MHz increment of the 1.5 – 1.7 GHz band. Applications for the device include GPS and Inmarsat satellite communications systems.

This refractory/gold metallized, ballasted overlay device is housed in the industry standard AMPAC™ Hermetic Metal/Ceramic package.

### PIN CONNECTION



- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	58	W
$I_C$	Device Current*	3.4	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.6	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 20mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4	—	—	V
$BV_{CES}$	$I_C = 20mA$		55	—	—	V
$I_{CES}$	$V_{CE} = 28V$		—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	20	—	300	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{IN}$	$f = 1.5 - 1.7GHz$	$P_{IN} = 7.0W$	$V_{CC} = 28V$	—	—	7.0	W
$\eta_C$	$f = 1.5 - 1.7GHz$	$P_{IN} = 7.0W$	$V_{CC} = 28V$	48	52	—	%
$G_P$	$f = 1.5 - 1.7GHz$	$P_{IN} = 7.0W$	$V_{CC} = 28V$	7.0	7.7	—	dB

Note: AM1517 series vary  $P_{IN}$  to achieve  $P_{OUT}$ ; performance guaranteed in 50 MHz increments.

Alpha-Suffix added to AM1517 P/N designates band segment.

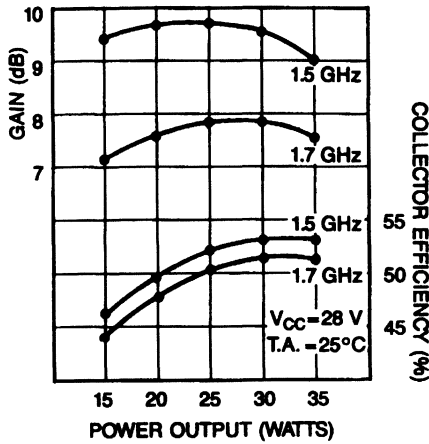
A -1500 - 1550 MHz

M -1620 - 1660 MHz

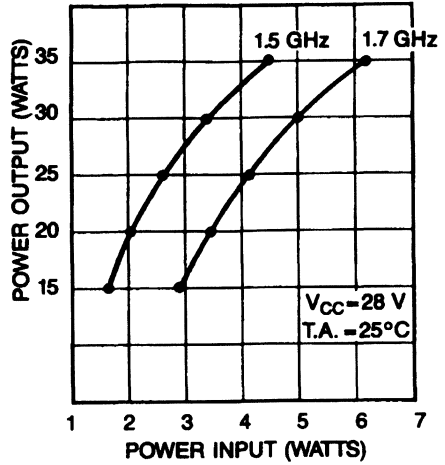
S -1625 - 1675 MHz

TYPICAL PERFORMANCE

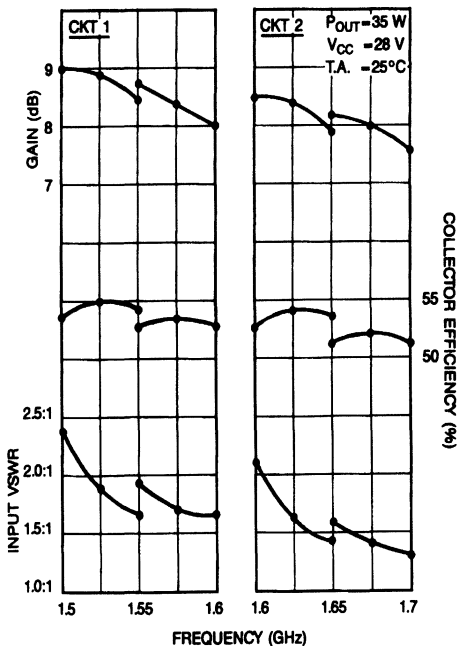
TYPICAL BAND EDGE GAIN & COLLECTOR EFFICIENCY vs POWER OUTPUT



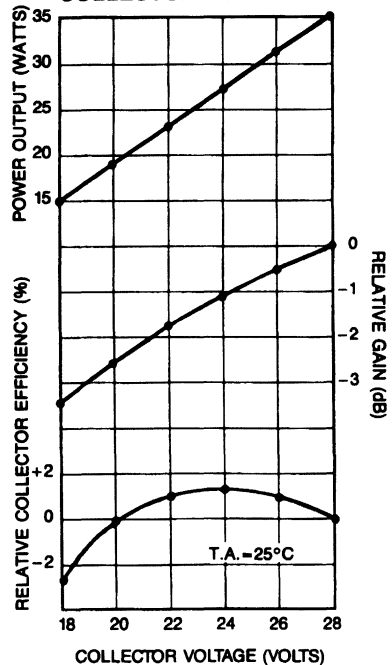
TYPICAL BAND EDGE POWER OUTPUT vs POWER INPUT



TYPICAL BROADBAND GAIN & COLLECTOR EFFICIENCY vs FREQUENCY IN 50 MHz INCREMENTS

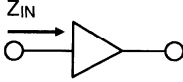


TYPICAL POWER OUTPUT, RELATIVE GAIN & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE

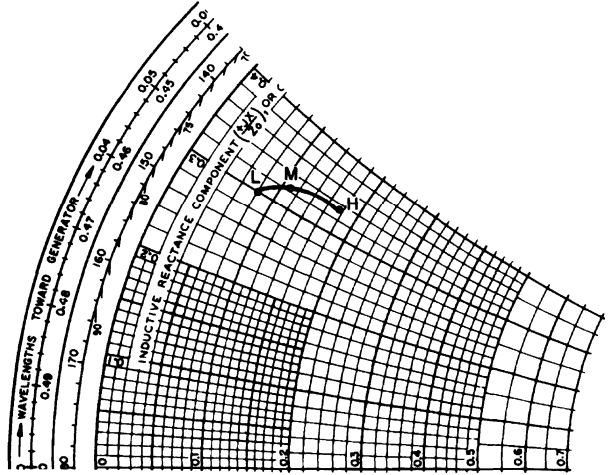


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

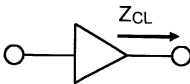


$P_{OUT} = 35\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 $Z_0 = 50\text{ ohms}$

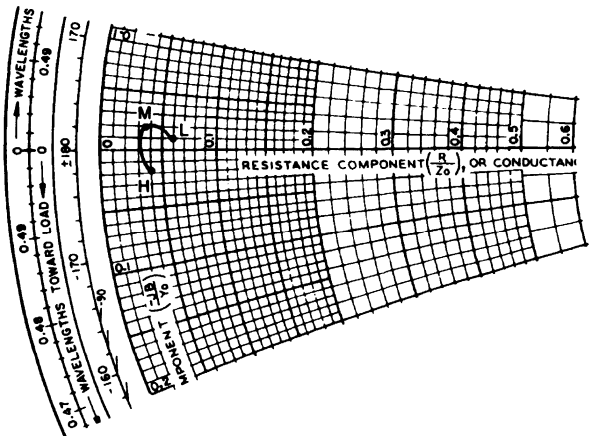


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1.5 GHz	$4.0 + j 15.0$	$3.0 + j 0.5$
M = 1.6 GHz	$5.5 + j 16.2$	$1.8 + j 1.0$
H = 1.7 GHz	$8.8 + j 16.8$	$2.0 - j 1.0$

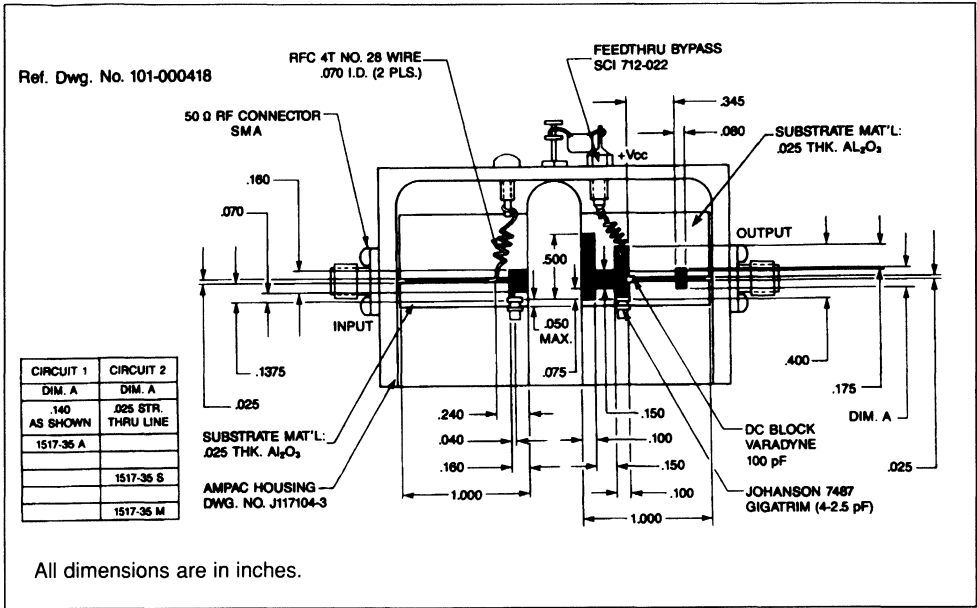
TYPICAL COLLECTOR LOAD IMPEDANCE



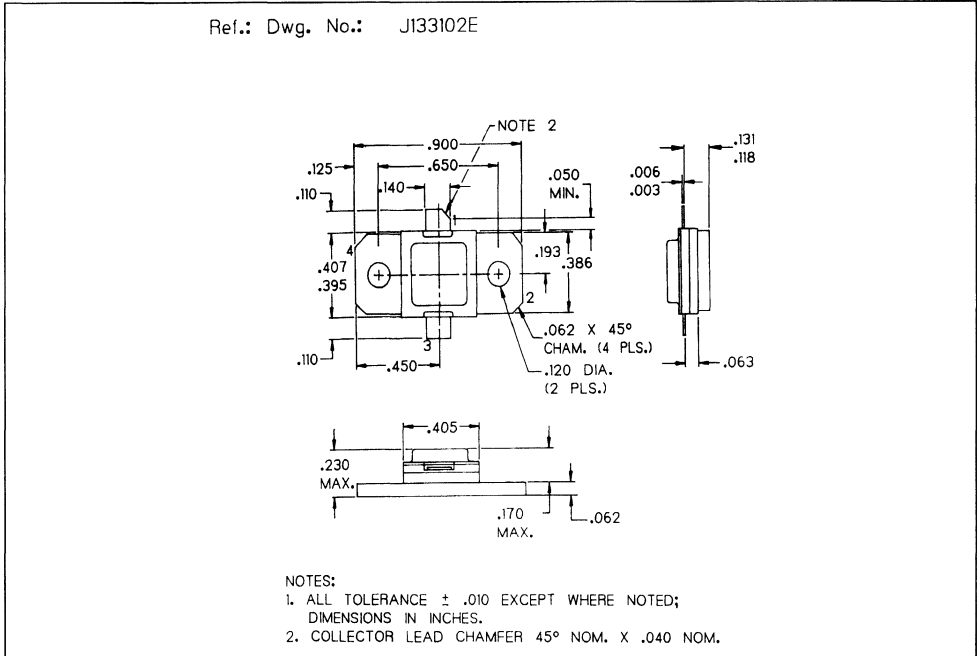
$P_{OUT} = 35\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 $Z_0 = 50\text{ ohms}$



TEST CIRCUIT



PACKAGE MECHANICAL DATA



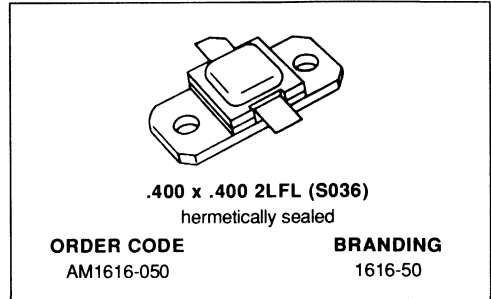




**RF & MICROWAVE TRANSISTORS**  
**SATELLITE COMMUNICATIONS APPLICATIONS**

PRELIMINARY DATA

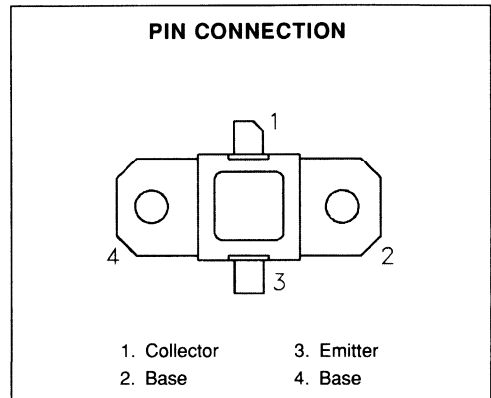
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 50$  W MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

The AM1616-050 is a high power Class C, CW transistor specifically designed for 1.6 GHz satellite communications applications including GPS and INMARSAT.

Refractory/Gold metallization and an Emitter-site ballasted overlay geometry ensure long term reliability for both satellite-based and earth terminal usages.

The AM1616-050 is housed in the proven AMPAC™ Hermetic Metal/Ceramic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	83	W
$I_C$	Device Current*	6.0	A
$V_{CC}$	Collector-Supply Voltage*	26	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.8	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

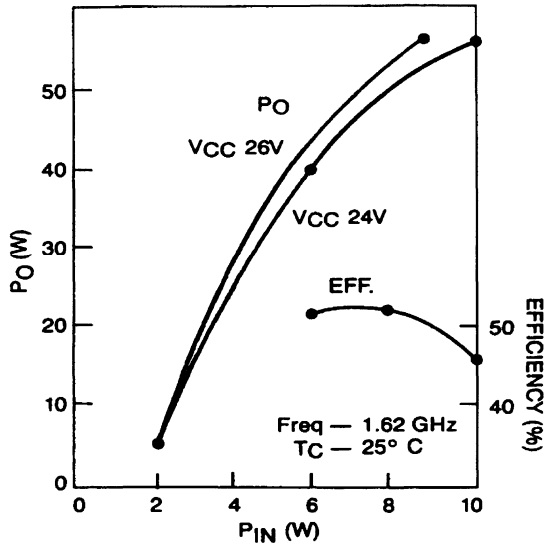
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 40mA$	$I_E = 0mA$	48	—	—	V
$BV_{EBO}$	$I_E = 4mA$	$I_C = 0mA$	4	—	—	V
$BV_{CES}$	$I_C = 40mA$		48	—	—	V
$I_{CES}$	$V_{CE} = 26V$		—	—	4	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	20	—	—	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{IN}$	$f = 1.62\text{ GHz}$	$P_{OUT} = 50W$	$V_{CC} = 26V$	—	—	10	W
$\eta_c$	$f = 1.62\text{ GHz}$	$P_{OUT} = 50W$	$V_{CC} = 26V$	45	52	—	%
GP	$f = 1.62\text{ GHz}$	$P_{OUT} = 50W$	$V_{CC} = 26V$	7.0	8.5	—	dB

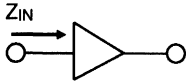
**TYPICAL PERFORMANCE**

**POWER OUTPUT & COLLECTOR EFFECIENCY vs POWER INPUT**

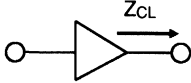


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

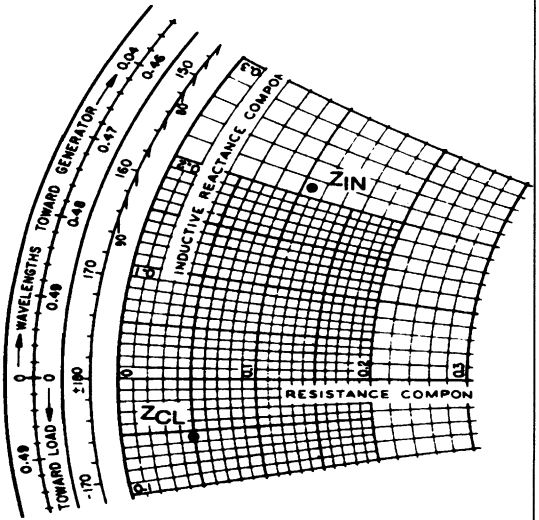


TYPICAL COLLECTOR LOAD IMPEDANCE

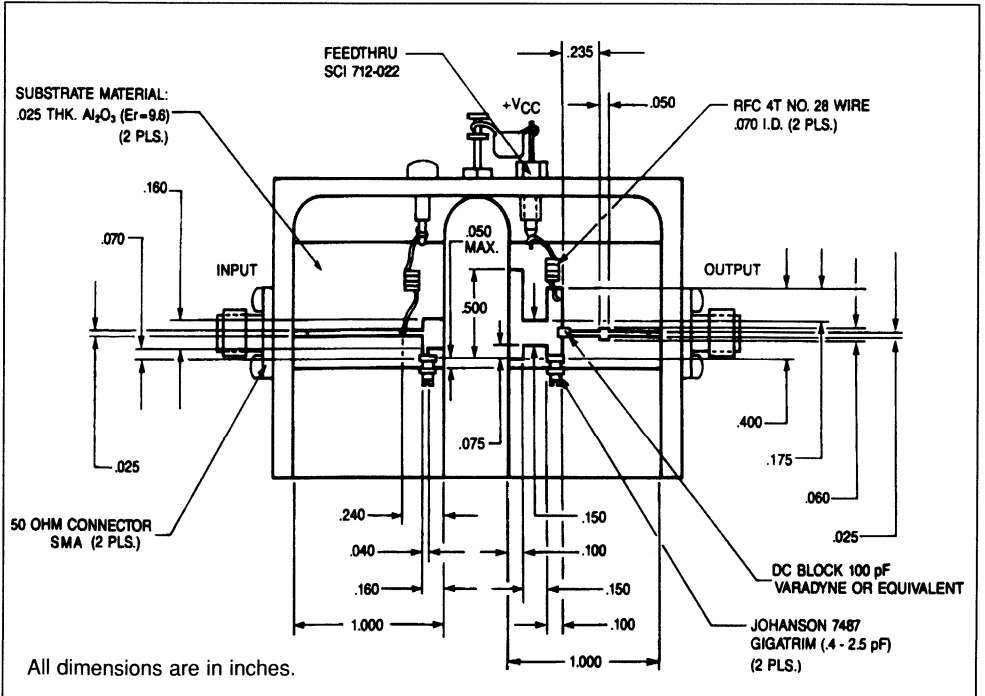


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1.62 GHz	5.5 + j 10.5	2.5 - j 2.8

P<sub>IN</sub> = 8 W  
 V<sub>CC</sub> = 26 V  
 Normalized to 50 ohms

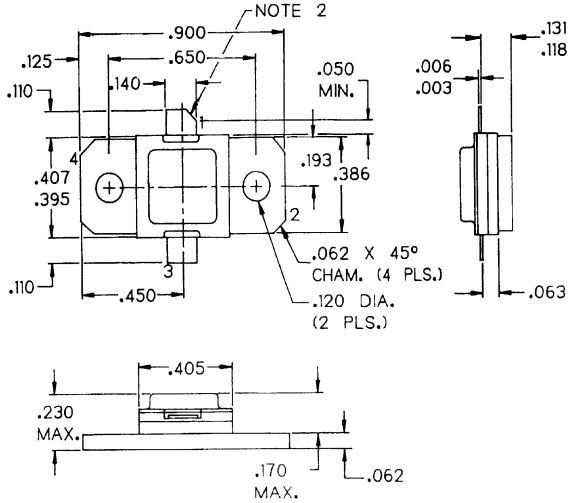


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E

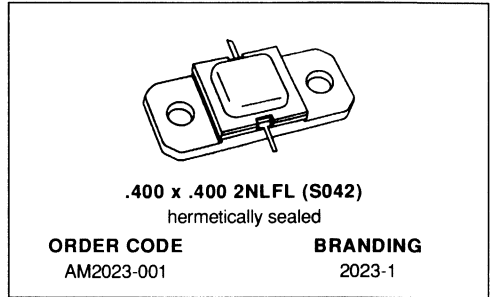


- NOTES:
- 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
  - 2. COLLECTOR LEAD CHAMFER  $45^\circ$  NOM. X  $.040$  NOM.

**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

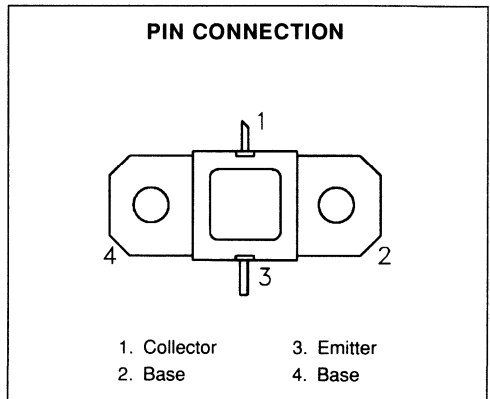
PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- INPUT/OUTPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 1.25W$  MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

The AM2023-001 is an internally-matched device specifically designed for 2 GHz telecommunications and telemetry applications.

Housed in the industry-standard AMPAC™ hermetic package, the AM2023-001 incorporates refractory-gold metallization for superior reliability in Class C power amplifier service.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 80^{\circ}C$ )	5.3	W
$I_C$	Device Current*	.245	A
$V_{CC}$	Collector-Supply Voltage*	24	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	22	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

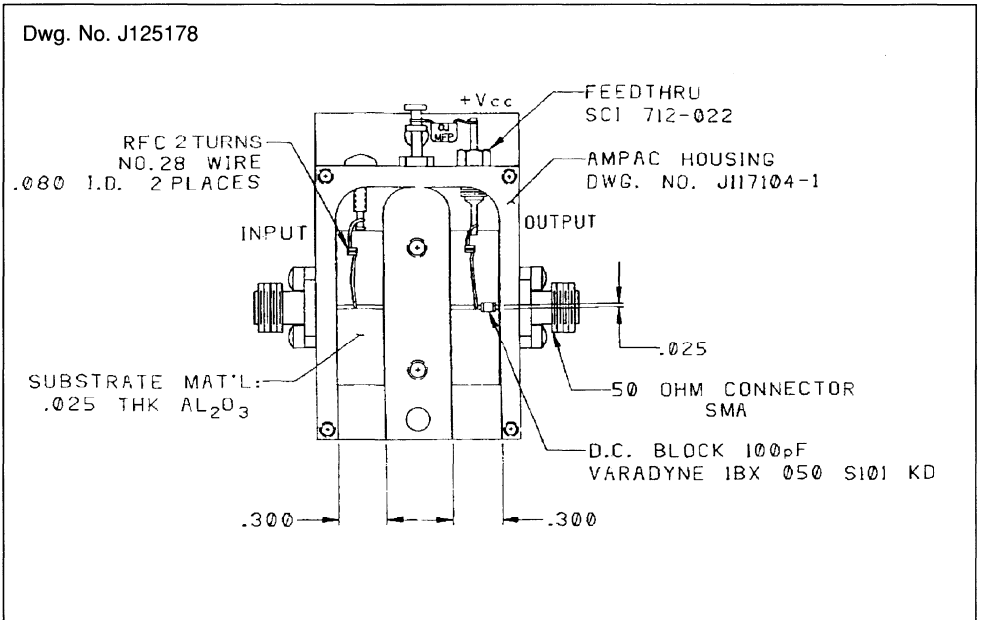
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	40	—	—	V
$I_{CES}$	$V_{CE} = 24V$		—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

**DYNAMIC**

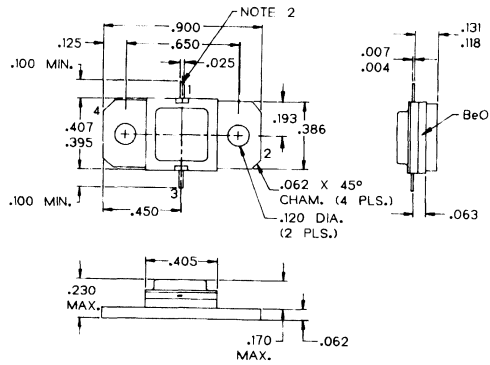
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2000 - 2300MHz$	$P_{IN} = 0.25W$	$V_{CC} = 24V$	1.25	—	—	W
$\eta_C$	$f = 2000 - 2300MHz$	$P_{IN} = 0.25W$	$V_{CC} = 24V$	45	—	—	%
$GP$	$f = 2000 - 2300MHz$	$P_{IN} = 0.25W$	$V_{CC} = 24V$	7.0	—	—	dB

**TEST CIRCUIT**



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.

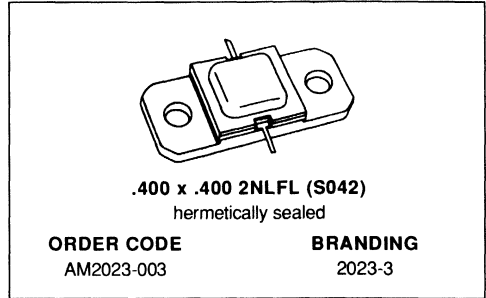




**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

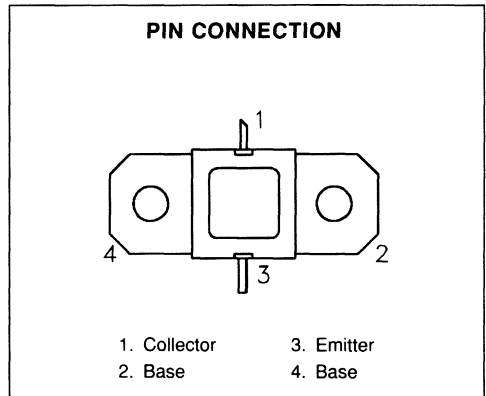
PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- INPUT/OUTPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 3.0$  W MIN. WITH 7.8 dB GAIN


**DESCRIPTION**

The AM2023-003 is an internally matched device specifically designed for 2 GHz telecommunications and telemetry applications.

Housed in the industry-standard AMPAC™ hermetic package, the AM2023-003 incorporates refractory-gold metallization for superior reliability in Class C power amplifier service.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 75^{\circ}C$ )	8.33	W
$I_C$	Device Current*	450	mA
$V_{CC}$	Collector-Supply Voltage*	26	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	15	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

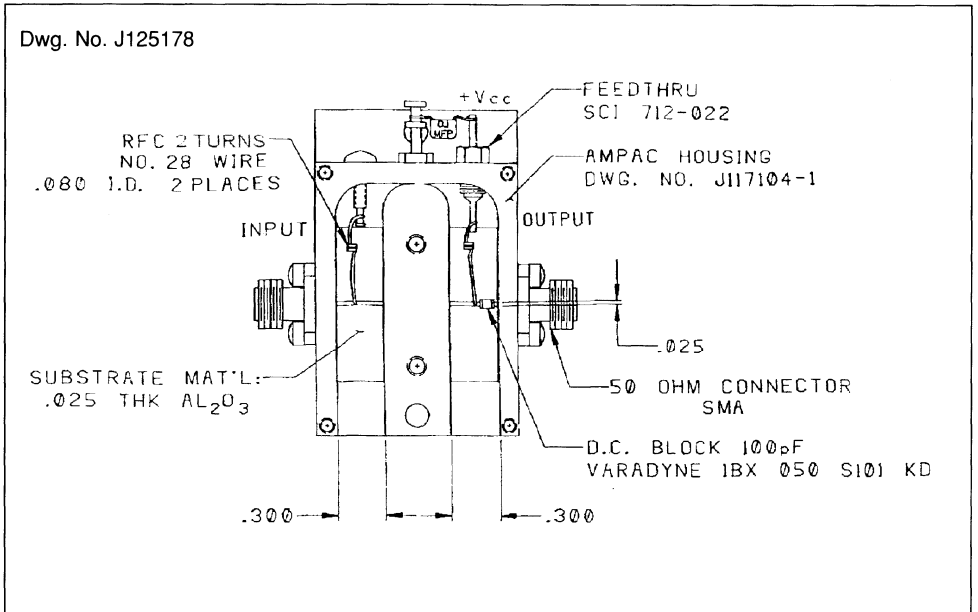
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	40	—	—	V
$I_{CBO}$	$V_{CB} = 24V$		—	—	500	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	15	—	120	—

**DYNAMIC**

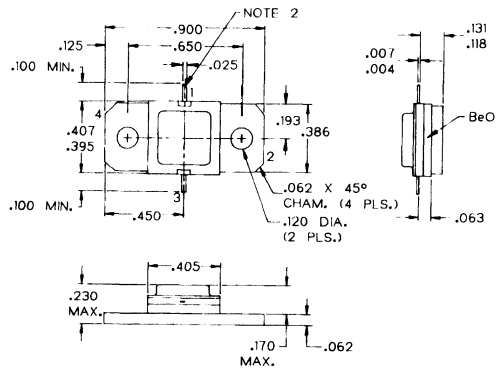
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2000 - 2300MHz$	$P_{IN} = 0.50W$	$V_{CC} = 24V$	3.0	—	—	W
$\eta_C$	$f = 2000 - 2300MHz$	$P_{IN} = 0.50W$	$V_{CC} = 24V$	50	—	—	%
GP	$f = 2000 - 2300MHz$	$P_{IN} = 0.50W$	$V_{CC} = 24V$	7.8	—	—	dB

**TEST CIRCUIT**



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

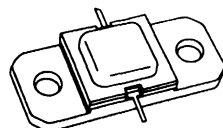
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- INPUT/OUTPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 6.0$  W MIN. WITH 7.8 dB GAIN


**.400 x .400 2N1FL (S042)**

hermetically sealed

**ORDER CODE**

AM2023-006

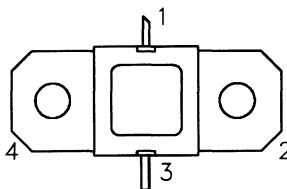
**BRANDING**

2023-6

**DESCRIPTION**

The AM2023-006 is an internally matched device specifically designed for 2 GHz, telecommunications and telemetry applications.

Housed in the industry-standard AMPAC™ hermetic package, the AM2023-006 incorporates refractory-gold metallization for superior reliability in Class C power amplifier service.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	18.4	W
$I_C$	Device Current*	.850	A
$V_{CC}$	Collector-Supply Voltage*	24	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	9.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

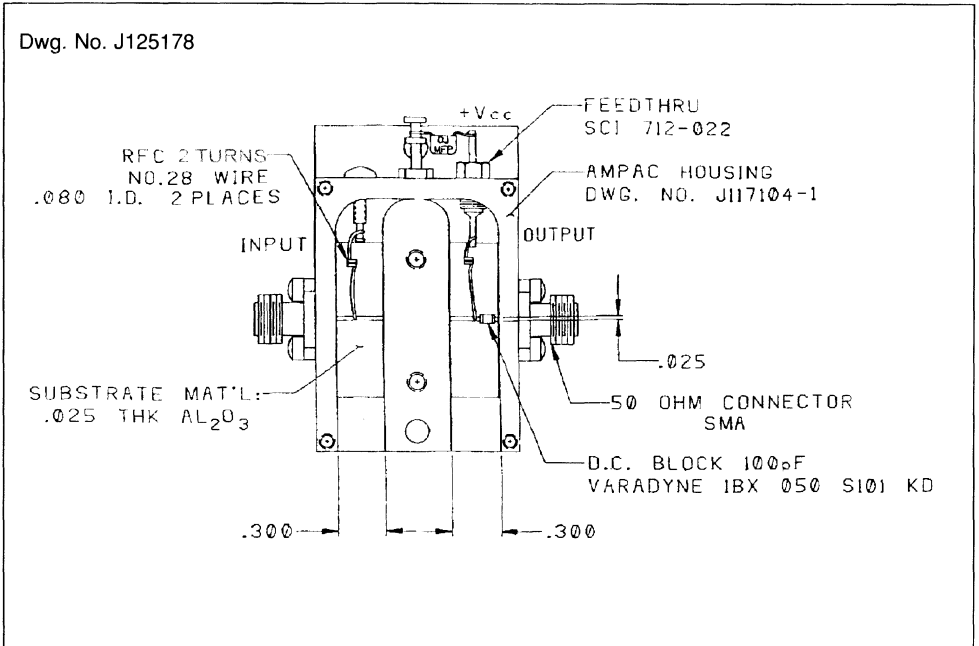
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 1mA	I <sub>E</sub> = 0mA	40	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.0	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 5mA	R <sub>BE</sub> = 10Ω	40	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 24V		—	—	500	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500mA	15	—	120	—

DYNAMIC

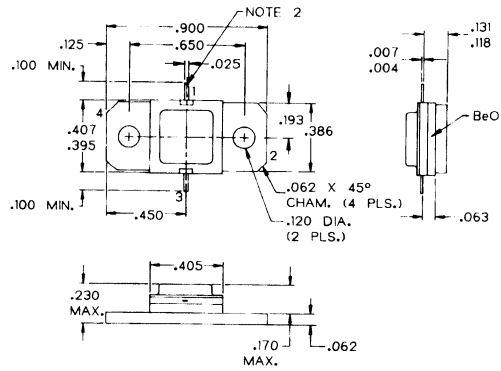
Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2000 — 2300MHz	P <sub>IN</sub> = 1.0W	V <sub>CC</sub> = 24V	6.0	—	—	W	
η <sub>c</sub>	f = 2000 — 2300MHz	P <sub>IN</sub> = 1.0W	V <sub>CC</sub> = 24V	40	—	—	%	
G <sub>p</sub>	f = 2000 — 2300MHz	P <sub>IN</sub> = 1.0W	V <sub>CC</sub> = 24V	7.8	—	—	dB	

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

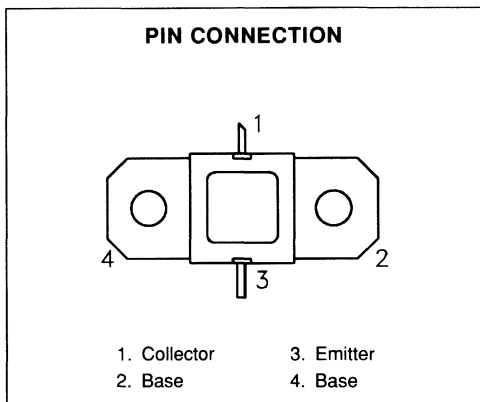
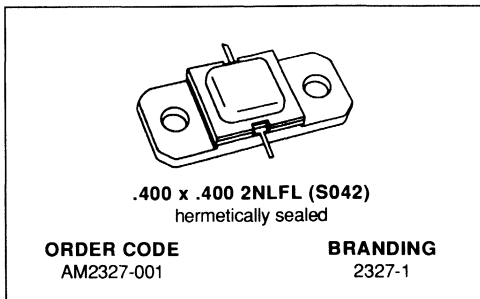
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.





## RF & MICROWAVE TRANSISTORS COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING TO 50 OHMS
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 1.0 W MIN. WITH 6.0 dB GAIN



### DESCRIPTION

The AM2327-001 is an internally matched device specifically designed for 2 GHz telecommunications and telemetry applications.

Housed in the industry-standard AMPAC™ hermetic package. The AM2327-001 incorporates refractory-gold metallization for superior reliability in Class C power amplifier service.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 100°C)	1.75	W
I <sub>c</sub>	Device Current*	0.12	A
V <sub>CC</sub>	Collector-Supply Voltage*	24	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	22	°C/W
----------------------	-----------------------------------	----	------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

# AM2327-001

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

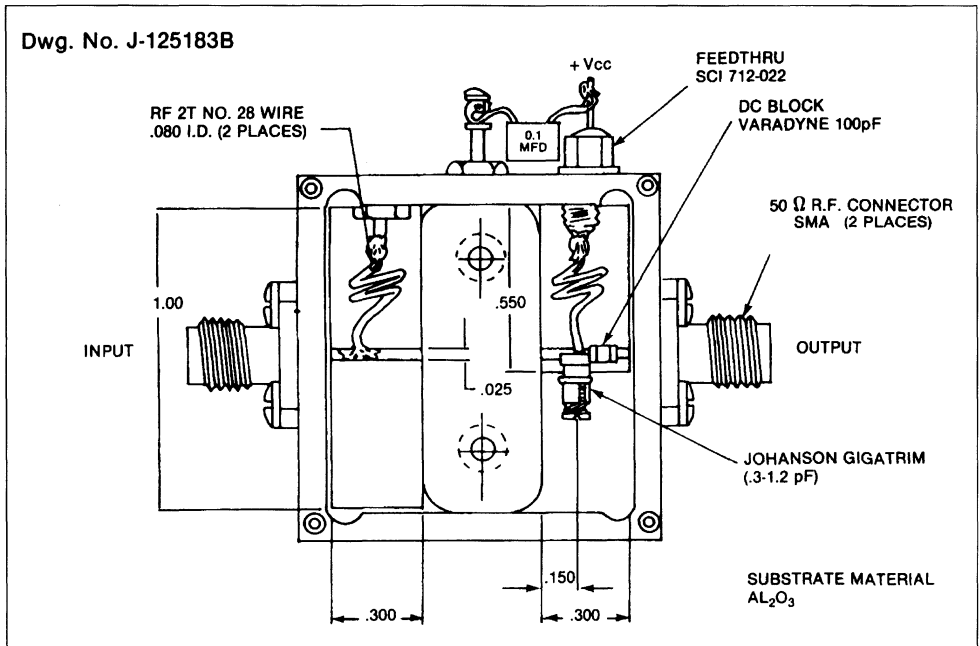
### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	40	—	—	V
$I_{CBO}$	$V_{BE} = 0V$	$V_{CB} = 24V$	—	—	500	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

### DYNAMIC

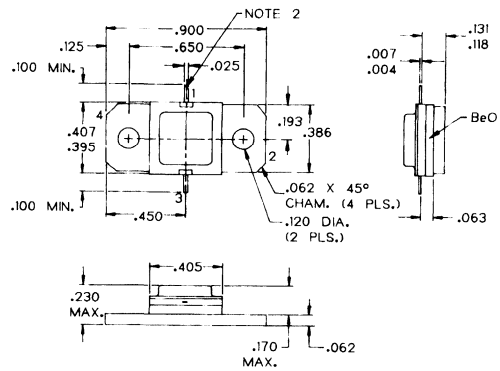
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2300 - 2700 MHz$	$P_{IN} = 0.25W$	$V_{CC} = 24V$	1.0	—	—	W
$\eta_c$	$f = 2300 - 2700 MHz$	$P_{IN} = 0.25W$	$V_{CC} = 24V$	35	—	—	%
$G_P$	$f = 2300 - 2700 MHz$	$P_{IN} = 0.25W$	$V_{CC} = 24V$	6.0	—	—	dB

### TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



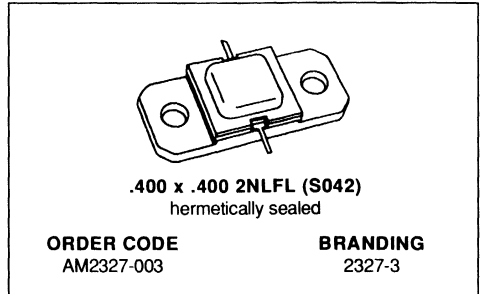
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



## RF & MICROWAVE TRANSISTORS COMMUNICATIONS APPLICATIONS

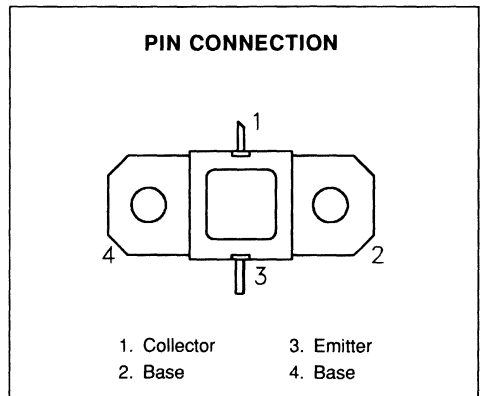
- REFRACTORY/GOLD METALLIZATION
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING TO 50 OHMS
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 2.6 \text{ W MIN. WITH } 7.2 \text{ dB GAIN}$



### DESCRIPTION

The AM2327-003 is an internally matched device specifically designed for 2 GHz telecommunications and telemetry applications.

Housed in the industry-standard AMPACT™ hermetic package. The AM2327-003 incorporates refractory-gold metallization for superior reliability in Class C power amplifier service.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	6.0	W
$I_c$	Device Current*	0.40	A
$V_{CC}$	Collector-Supply Voltage*	24	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	15	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

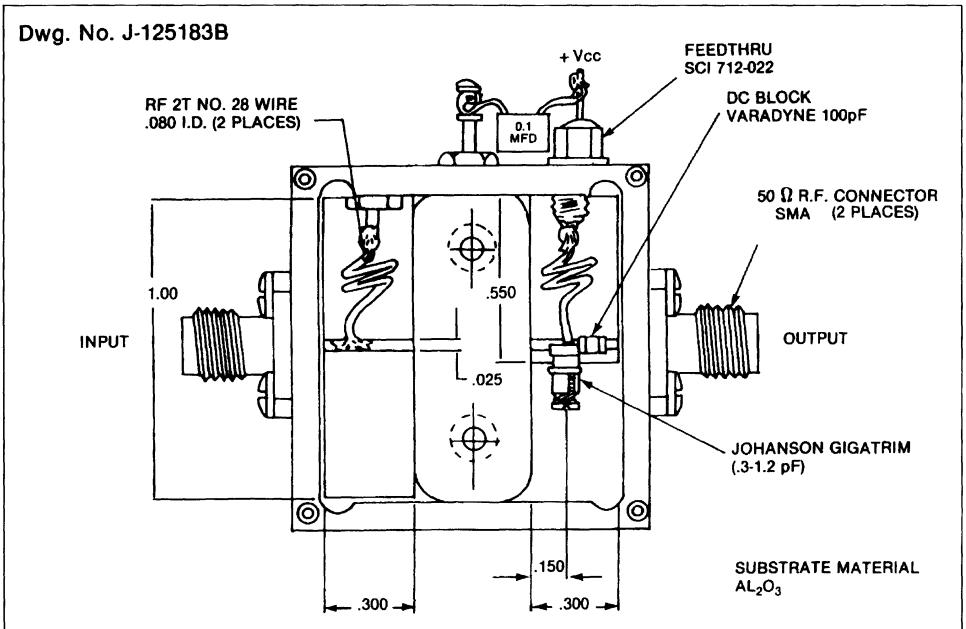
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	40	—	—	V
$I_{CBO}$	$V_{BE} = 0V$	$V_{CB} = 24V$	—	—	500	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	15	—	120	—

**DYNAMIC**

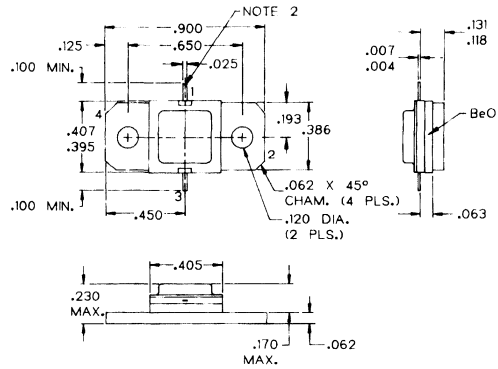
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2300 - 2700 MHz$	$P_{IN} = 0.50W$	$V_{CC} = 24V$	2.6	—	—	W
$\eta_C$	$f = 2300 - 2700 MHz$	$P_{IN} = 0.50W$	$V_{CC} = 24V$	40	—	—	%
$G_P$	$f = 2300 - 2700 MHz$	$P_{IN} = 0.50W$	$V_{CC} = 24V$	7.2	—	—	dB

**TEST CIRCUIT**



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

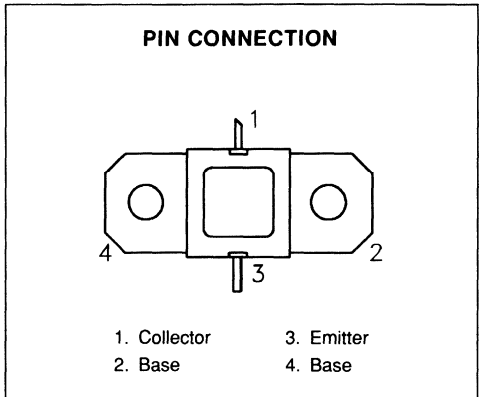
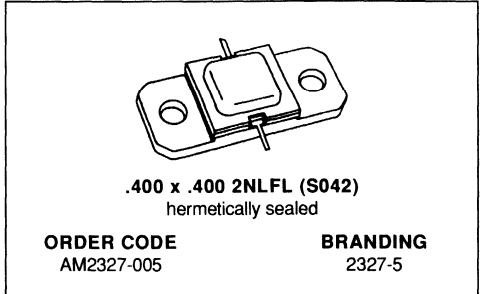
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.





## RF & MICROWAVE TRANSISTORS COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING TO 50 OHMS
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 5.0 W MIN. WITH 7.0 dB GAIN



### DESCRIPTION

The AM2327-005 is an internally matched device specifically designed for 2 GHz telecommunications and telemetry applications.

Housed in the industry-standard AMPAC™ hermetic package. The AM2327-005 incorporates refractory-gold metallization for superior reliability in Class C power amplifier service.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	12.0	W
I <sub>C</sub>	Device Current*	0.75	A
V <sub>CC</sub>	Collector-Supply Voltage*	24	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	9.0	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

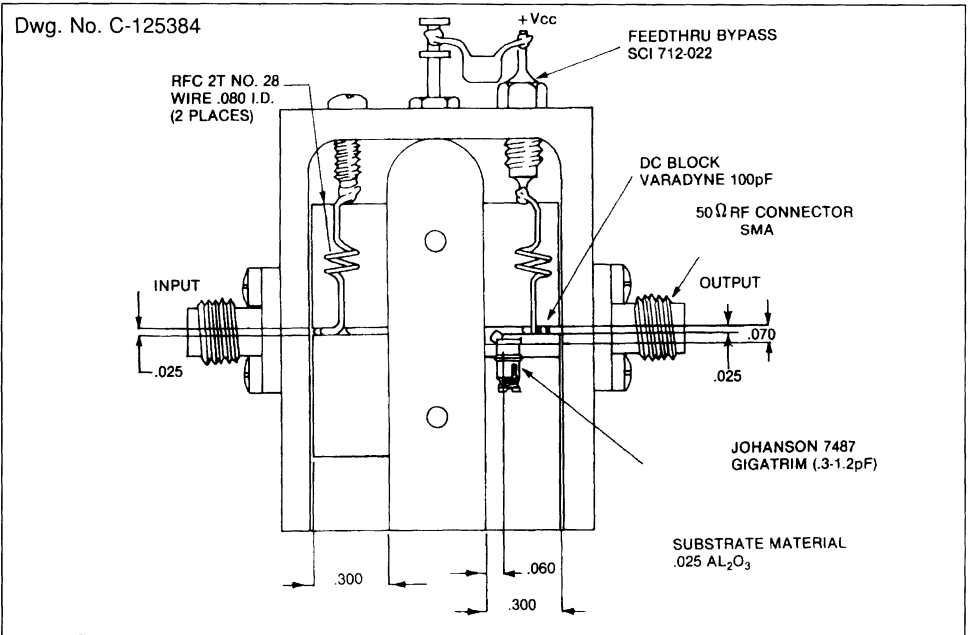
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.0	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = \Omega$	40	—	—	V
$I_{CBO}$	$V_{BE} = 0V$	$V_{CB} = 24V$	—	—	500	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	15	—	120	—

**DYNAMIC**

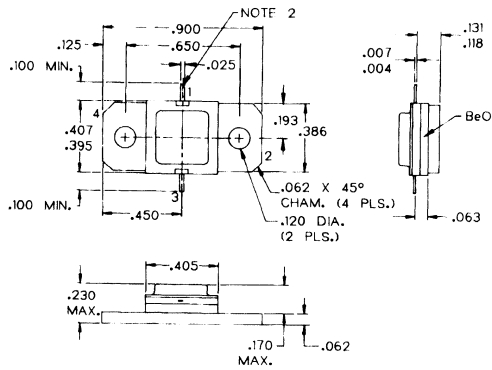
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2300 - 2700MHz$	$P_{IN} = 1.0W$	$V_{CC} = 24V$	5.0	—	—	W
$\eta_c$	$f = 2300 - 2700MHz$	$P_{IN} = 1.0W$	$V_{CC} = 24V$	35	—	—	%
$G_P$	$f = 2300 - 2700MHz$	$P_{IN} = 1.0W$	$V_{CC} = 24V$	7.0	—	—	dB

**TEST CIRCUIT**



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



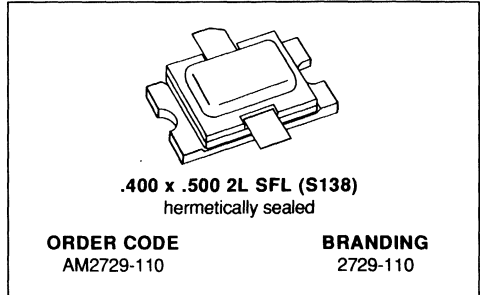
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

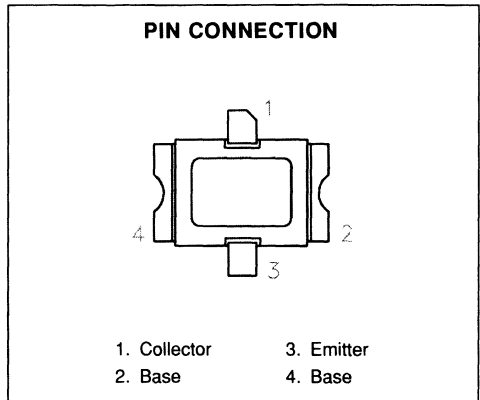
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 105$  W MIN. WITH 6.5 dB GAIN


**DESCRIPTION**

The AM2729-110 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 3:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM2729-110 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	438	W
$I_c$	Device Current*	12	A
$V_{CC}$	Collector-Supply Voltage*	48	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.4	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 40mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 8mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 40mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 40V$	—	—	30	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 4A$	30	—	—	—

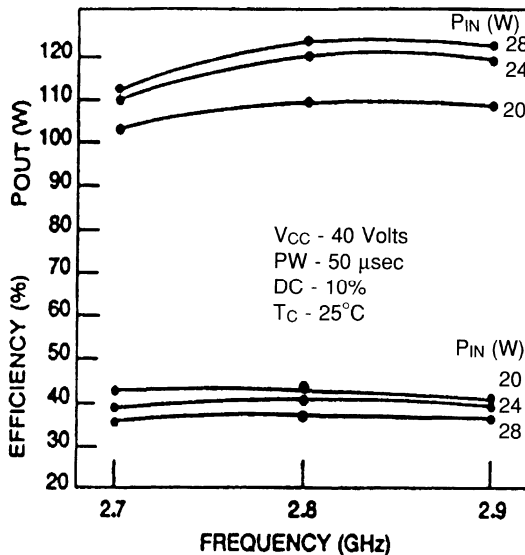
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2700 - 2900MHz$	$P_{IN} = 23.5W$	$V_{CC} = 40V$	105	115	—	W
$\eta_c$	$f = 2700 - 2900MHz$	$P_{IN} = 23.5W$	$V_{CC} = 40V$	33	40	—	%
GP	$f = 2700 - 2900MHz$	$P_{IN} = 23.5W$	$V_{CC} = 40V$	6.5	6.9	—	dB

Note: Pulse Width = 50  $\mu$ Sec  
 Duty Cycle = 10%

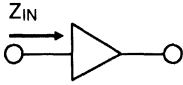
**TYPICAL PERFORMANCE**

**TYPICAL BROADBAND PERFORMANCE**

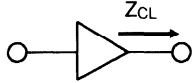


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

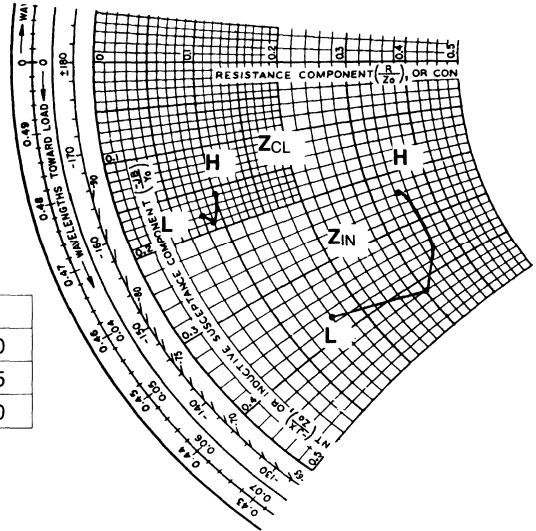


TYPICAL COLLECTOR LOAD IMPEDANCE

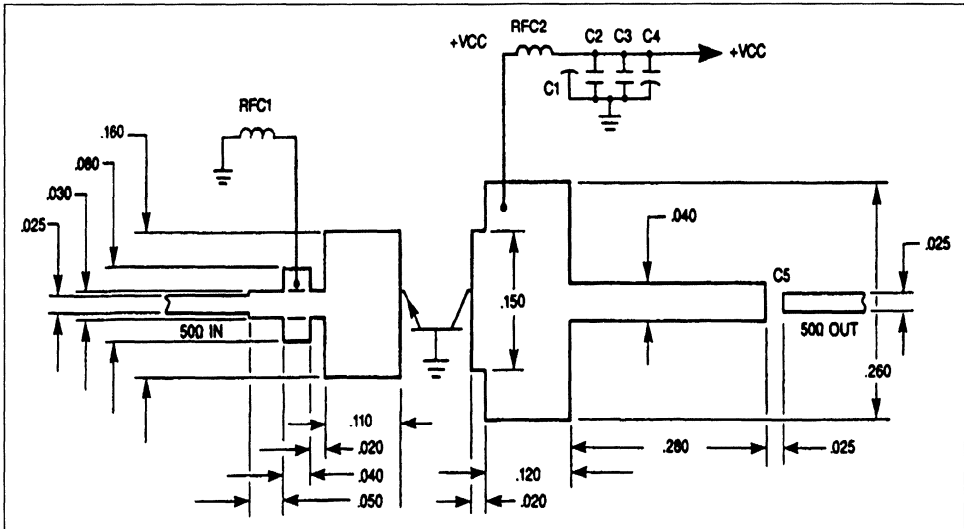


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	8.0 - j 18.5	4.0 - j 9.0
M = 2.8 GHz	15.0 - j 21.0	4.5 - j 9.5
H = 2.9 GHz	17.3 - j 12.0	5.0 - j 8.0

P<sub>IN</sub> = 23.5 W  
 V<sub>CC</sub> = 40 V  
 Normalized to 50 ohms



TEST CIRCUIT



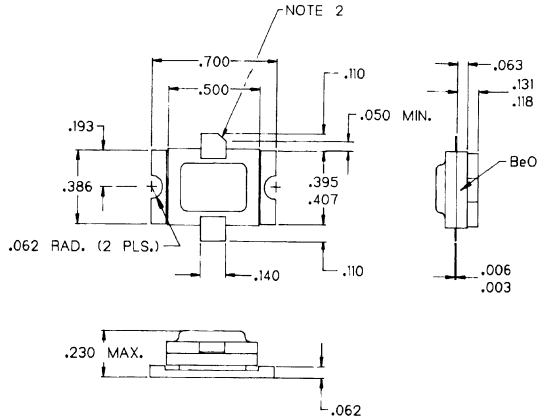
All dimensions are in inches.  
 Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub>

- C1 : 1500 pF RF Feedthrough
- C2 : 1 μF CK06 Capacitor
- C3 : 1 μF Tantalum Capacitor
- C4 : 100 μF Electrolytic Capacitor, 63V

- C5 : 22 pF Chip Capacitor
- RFC1 : No. 26 Wire, 2 Turn .08 I.D.
- RFC2 : No. 26 Wire, 2 Turn .08 I.D.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: 103-000737A



NOTES:

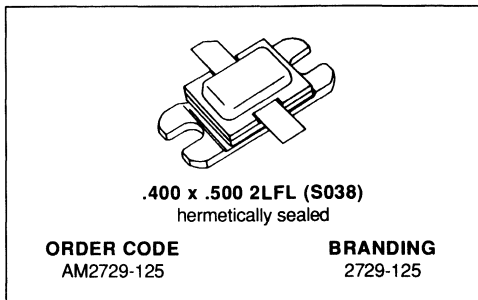
1. ALL TOLERANCES  $\pm$  .010 EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

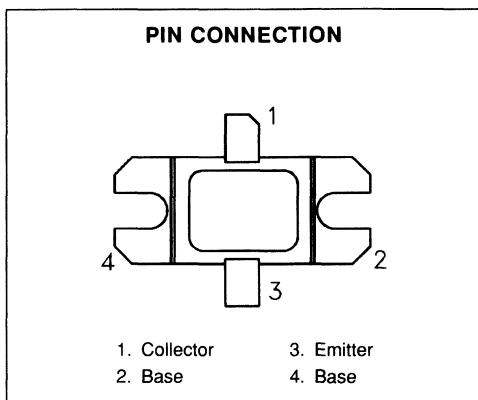
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 125$  W MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

The AM2729-125 device is a high power silicon bipolar NPN transistor specifically designed for medium pulse S-Band radar output and driver applications.

This device is characterized at 50  $\mu$ sec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM2729-125 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 75^{\circ}C$ )	500	W
$I_c$	Device Current*	16	A
$V_{CC}$	Collector-Supply Voltage*	45	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.35	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

STATIC

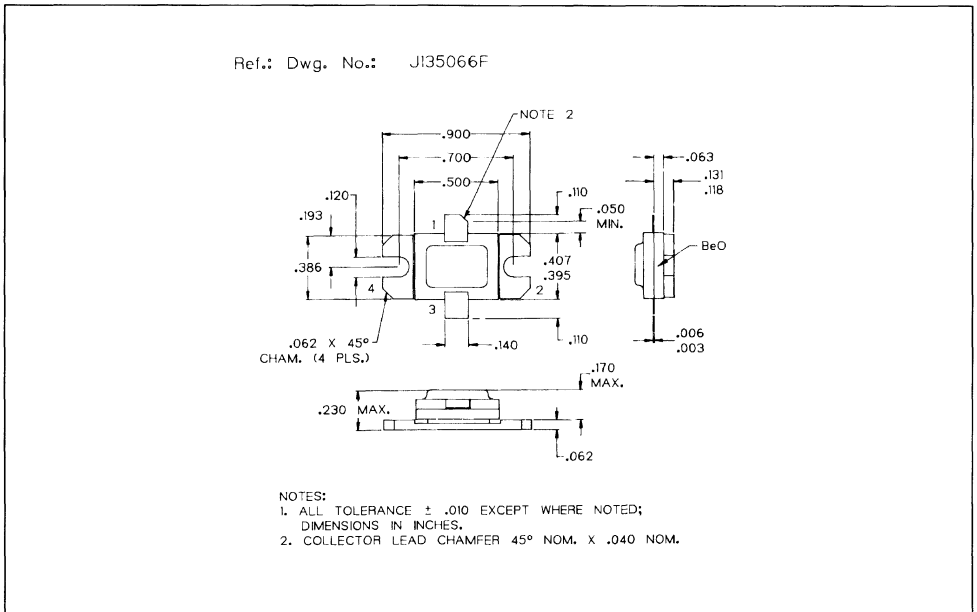
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 40V$	—	—	40	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	30	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2700 - 2900MHz$	$P_{IN} = 25W$	$V_{CC} = 40V$	125	—	—	W
$\eta_c$	$f = 2700 - 2900MHz$	$P_{IN} = 25W$	$V_{CC} = 40V$	35	—	—	%
GP	$f = 2700 - 2900MHz$	$P_{IN} = 25W$	$V_{CC} = 40V$	7.0	—	—	dB

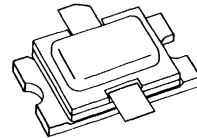
Note: Pulse Width = 50µSec  
 Duty Cycle = 10%

PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 105$  W MIN. WITH 6.2 dB GAIN



**.400 x .500 2L SFL (S138)**  
hermetically sealed

**ORDER CODE**  
AM2931-110

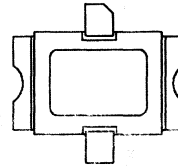
**BRANDING**  
2931-110

**DESCRIPTION**

The AM2931-110 is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 3:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM2931-110 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching circuitry, and is intended for military and other high reliability applications.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	375	W
$I_C$	Device Current*	12	A
$V_{CC}$	Collector-Supply Voltage*	48	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.40	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (Tcase = 25°C)

STATIC

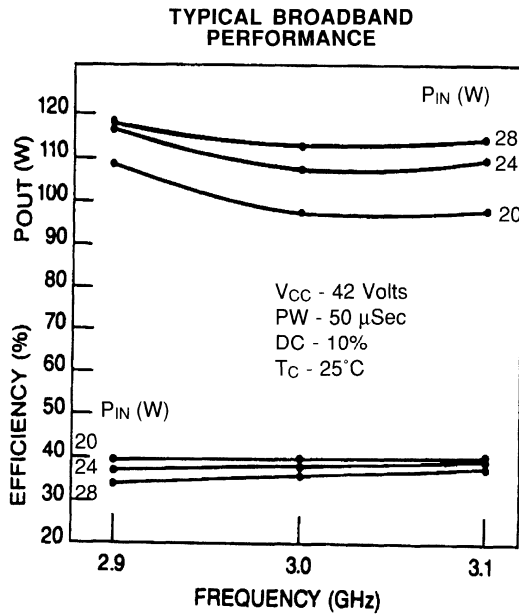
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 40mA	I <sub>E</sub> = 0mA	55	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 8mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 40mA	R <sub>BE</sub> = 10Ω	55	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 42V	—	—	30	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 4A	30	—	—	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2900 — 3100MHz	P <sub>IN</sub> = 25W	V <sub>CC</sub> = 42V	105	115	—	W
η <sub>c</sub>	f = 2900 — 3100MHz	P <sub>IN</sub> = 25W	V <sub>CC</sub> = 42V	32	40	—	%
GP	f = 2900 — 3100MHz	P <sub>IN</sub> = 25W	V <sub>CC</sub> = 42V	6.2	6.6	—	dB

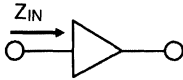
Note: Pulse Width = 50 μSec  
 Duty Cycle = 10%

TYPICAL PERFORMANCE

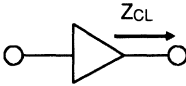


IMPEDANCE DATA

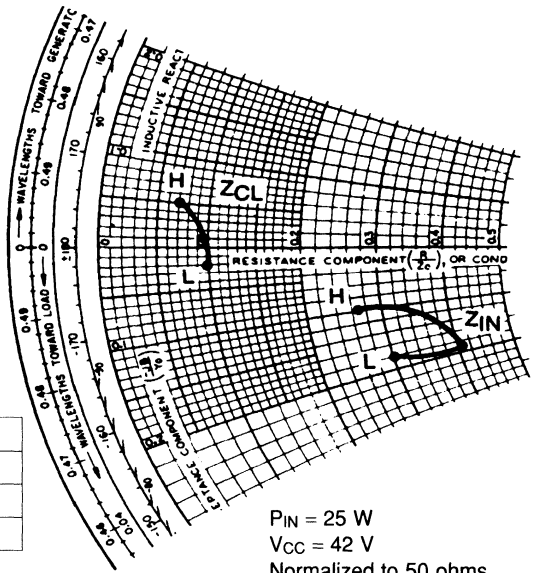
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

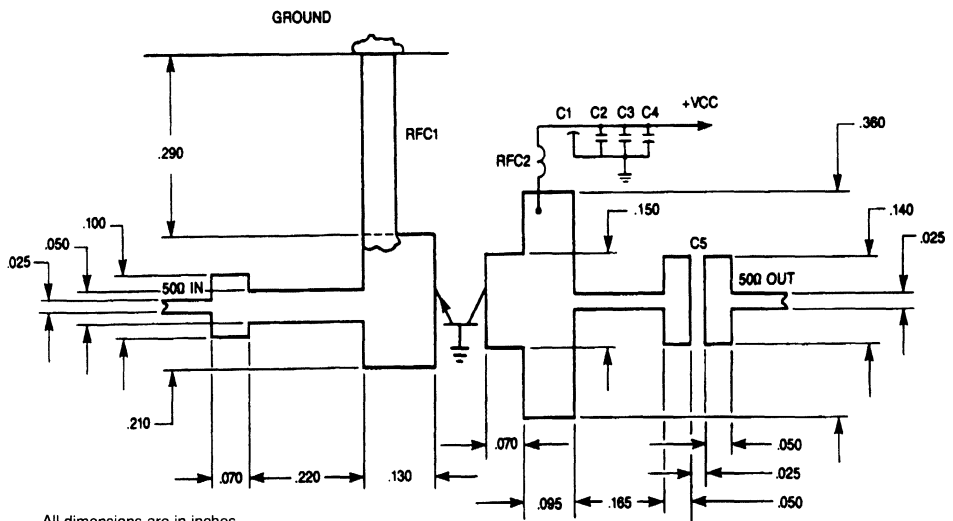


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.9 GHz	15.0 - j 9.0	5.0 - j 1.0
M = 3.0 GHz	20.0 - j 9.5	4.8 + j 0.5
H = 3.1 GHz	13.5 - j 5.0	3.5 + j 2.5



P<sub>IN</sub> = 25 W  
 V<sub>CC</sub> = 42 V  
 Normalized to 50 ohms

TEST CIRCUIT



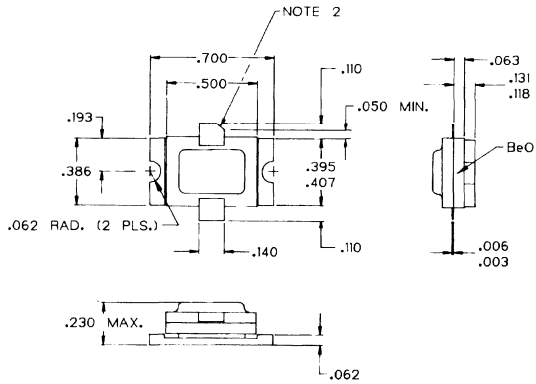
All dimensions are in inches.  
 Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub> (Er = 9.6)

- C1 : 1500 pF RF Feedthrough
- C2 : 1 μF, CK06 Capacitor
- C3 : 1 μF, Tantalum Capacitor
- C4 : 100 μF Electrolytic Capacitor, 63V

- C5 : 22 pF Chip Capacitor (bridge at location indicated)
- RFC1 : Gold Plated Nickel Strap, 0.060 Inch Wide, 0.005 Inch Thick, 0.290 Inch Long
- RFC2 : No. 26 Wire, 2 Turn .080 Inch I.D.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: 103-000737A



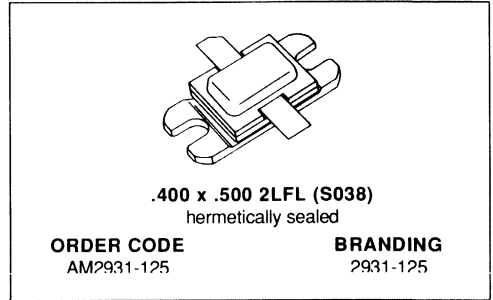
NOTES:

1. ALL TOLERANCES  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

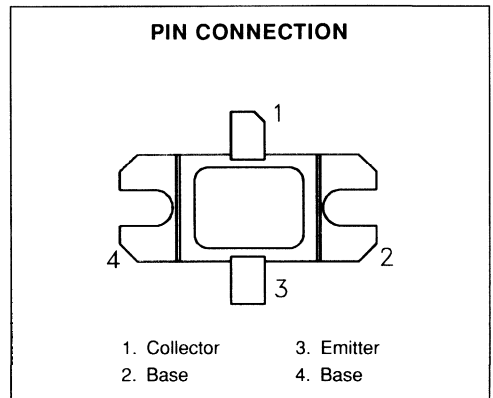
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 125 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$


**DESCRIPTION**

The AM2931-125 device is a high power silicon bipolar NPN transistor specifically designed for medium pulse S-Band radar output and driver applications.

This device is characterized at 50  $\mu\text{sec}$  pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM2931-125 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^\circ\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 75^\circ\text{C}$ )	500	W
$I_c$	Device Current*	16	A
$V_{CC}$	Collector-Supply Voltage*	45	V
$T_j$	Junction Temperature (Pulsed RF Operation)	250	$^\circ\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^\circ\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.35	$^\circ\text{C/W}$
---------------	-----------------------------------	------	--------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

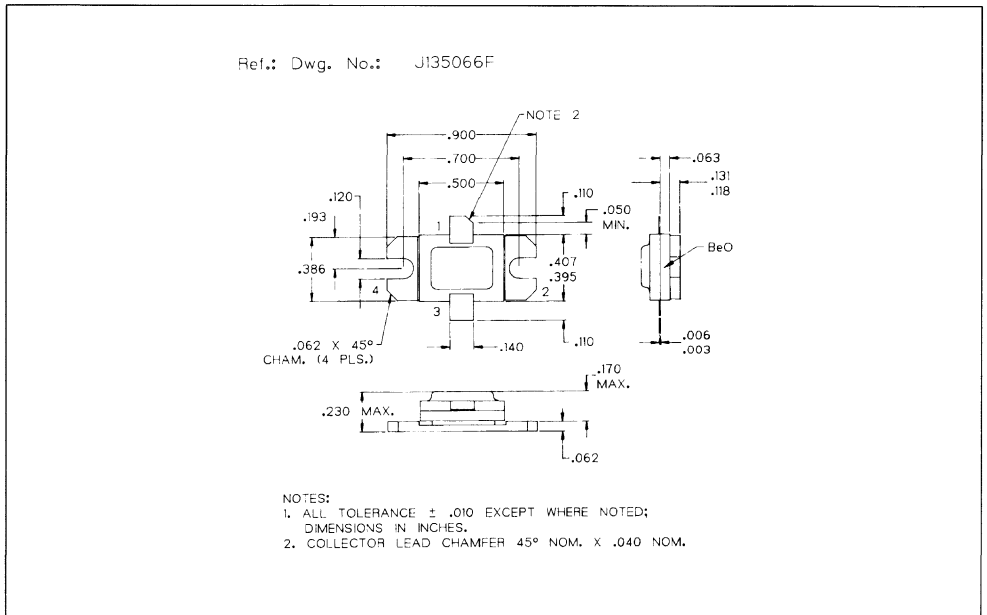
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 42V$	—	—	40	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	30	—	300	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2900 - 3100MHz$	$P_{IN} = 25W$	$V_{CC} = 42V$	125	—	—	W
$\eta_C$	$f = 2900 - 3100MHz$	$P_{IN} = 25W$	$V_{CC} = 42V$	35	—	—	%
GP	$f = 2900 - 3100MHz$	$P_{IN} = 25W$	$V_{CC} = 42V$	7.0	—	—	dB

Note: Pulse Width = 50µSec  
 Duty Cycle = 10%

**PACKAGE MECHANICAL DATA**





**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

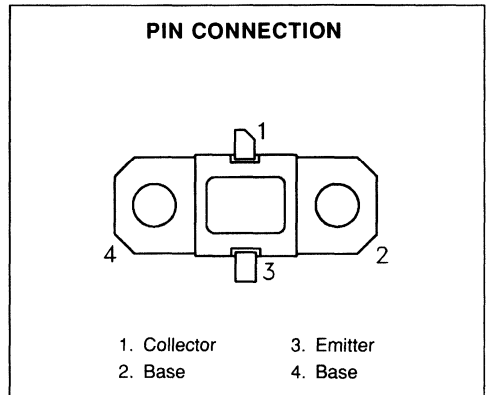
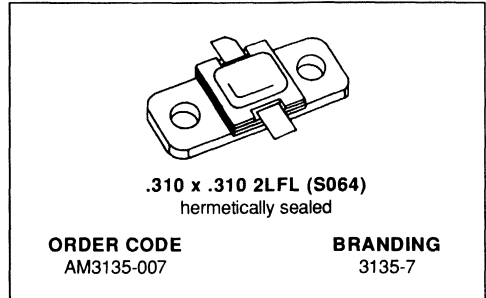
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 6.5 \text{ W MIN. WITH } 6.0 \text{ dB GAIN}$

**DESCRIPTION**

The AM3135-007 device is a high power silicon bipolar NPN transistor specifically designed for long pulse S-Band radar output and driver applications.

This device is characterized at 500  $\mu\text{sec}$  pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM3135-007 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^\circ\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^\circ\text{C}$ )	34	W
$I_C$	Device Current*	1.2	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^\circ\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^\circ\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	5.8	$^\circ\text{C/W}$
---------------	-----------------------------------	-----	--------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

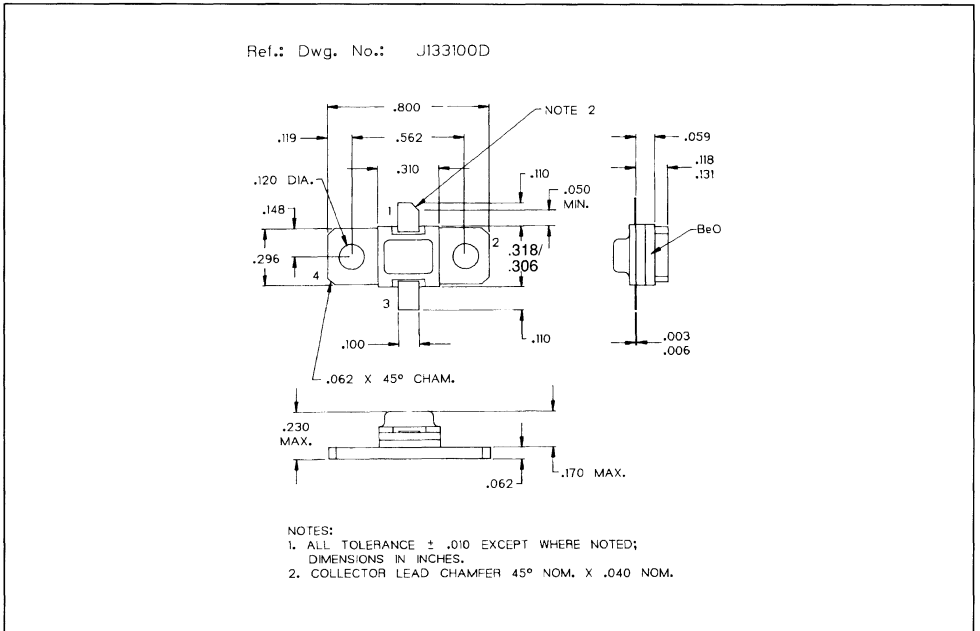
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 7mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 7mA	V <sub>BE</sub> = 0V	45	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 30V	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 600mA	30	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 3100 — 3500MHz	P <sub>IN</sub> = 1.63W	V <sub>CC</sub> = 30V	6.5	—	—	W
η <sub>c</sub>	f = 3100 — 3500MHz	P <sub>IN</sub> = 1.63W	V <sub>CC</sub> = 30V	30	—	—	%
GP	f = 3100 — 3500MHz	P <sub>IN</sub> = 1.63W	V <sub>CC</sub> = 30V	6.0	—	—	dB

Note: Pulse Width = 500μSec  
 Duty Cycle = 10%

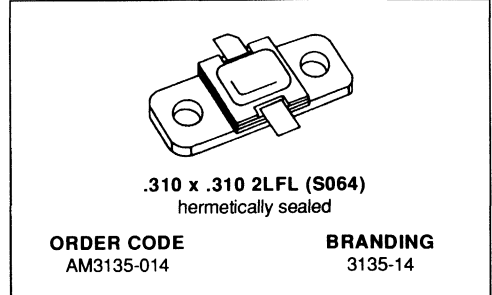
PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

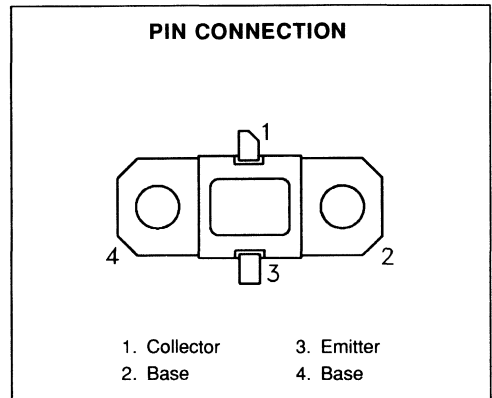
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 13.5 \text{ W MIN. WITH } 6.0 \text{ dB GAIN}$


**DESCRIPTION**

The AM3135-014 device is a high power silicon bipolar NPN transistor specifically designed for long pulse S-Band radar output and driver applications.

This device is characterized at 500  $\mu\text{sec}$  pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM3135-014 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}\text{C}$ )	57	W
$I_C$	Device Current*	1.8	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	3.5	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

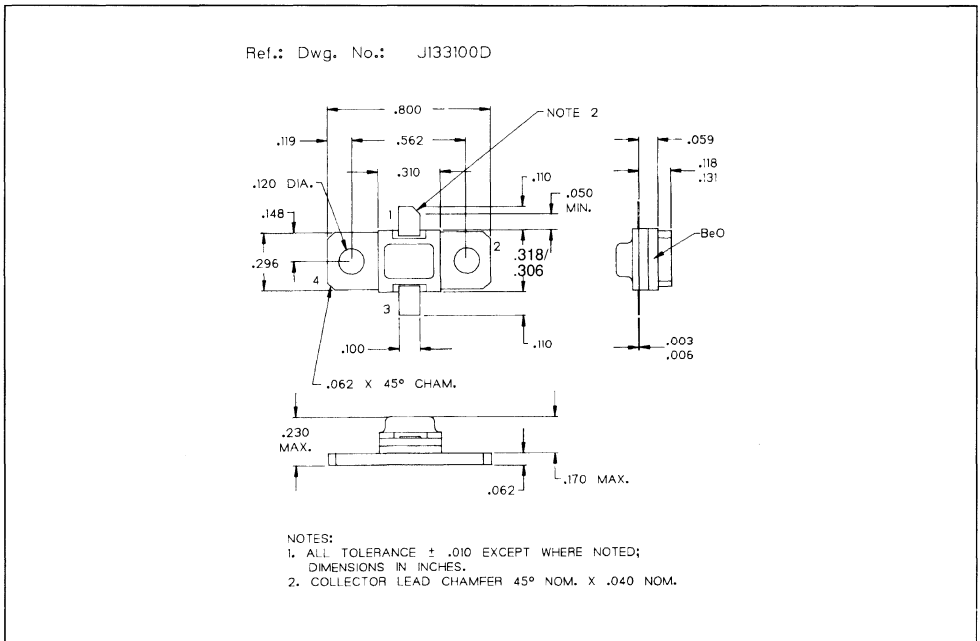
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 10mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 2mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 10mA	V <sub>BE</sub> = 0V	45	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 30V	—	—	8	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	30	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 3100 — 3500MHz	P <sub>IN</sub> = 3.4W	V <sub>CC</sub> = 30V	13.5	—	—	W
η <sub>C</sub>	f = 3100 — 3500MHz	P <sub>IN</sub> = 3.4W	V <sub>CC</sub> = 30V	32	—	—	%
G <sub>P</sub>	f = 3100 — 3500MHz	P <sub>IN</sub> = 3.4W	V <sub>CC</sub> = 30V	6.0	—	—	dB

Note: Pulse Width = 500μSec  
 Duty Cycle = 10%

PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

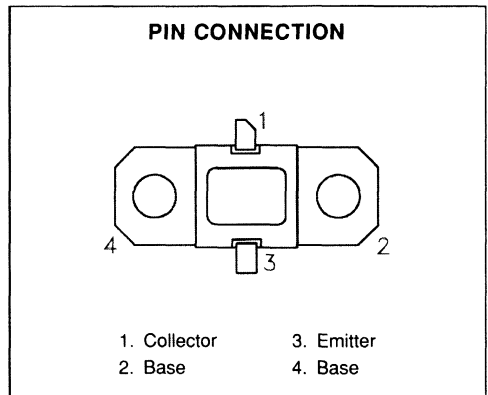
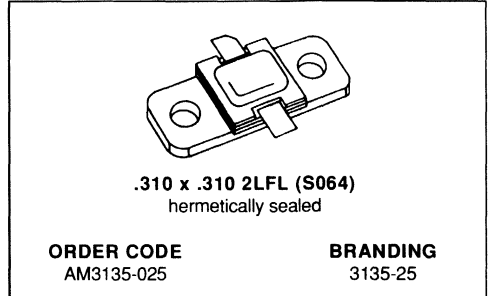
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY @ 1 dB OVERDRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 30$  W MIN. WITH 6.8 dB GAIN

**DESCRIPTION**

The AM3135-025 device is a high power silicon bipolar NPN transistor specifically designed for long pulse S-Band radar output and driver applications.

This device is characterized at 500  $\mu$ sec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM3135-025 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	100	W
$I_C$	Device Current*	3.3	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 20mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 4mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 20mA$	$V_{BE} = 0V$	45	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 30V$	—	—	15	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	30	—	—	—

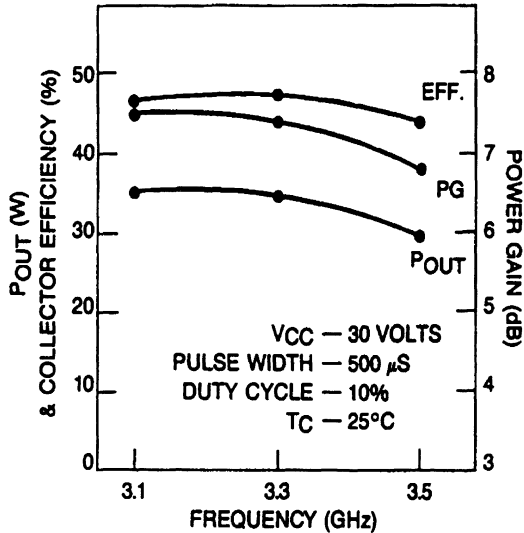
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.1 - 3.5GHz$	$P_{IN} = 6.25W$	$V_{CC} = 30V$	25	30	—	W
$\eta_C$	$f = 3.1 - 3.5GHz$	$P_{IN} = 6.25W$	$V_{CC} = 30V$	35	44	—	%
$G_P$	$f = 3.1 - 3.5GHz$	$P_{IN} = 6.25W$	$V_{CC} = 30V$	6.0	6.8	—	dB

Note: Pulse Width = 500  $\mu$ Sec  
 Duty Cycle = 10%

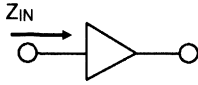
**TYPICAL PERFORMANCE**

**TYPICAL BROADBAND PERFORMANCE**

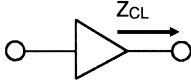


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

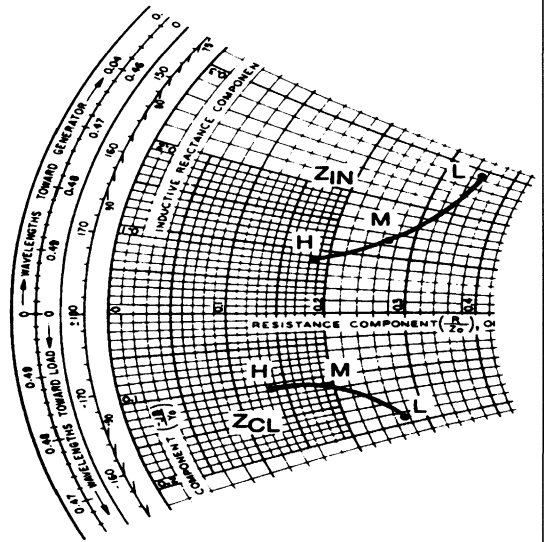


TYPICAL COLLECTOR LOAD IMPEDANCE

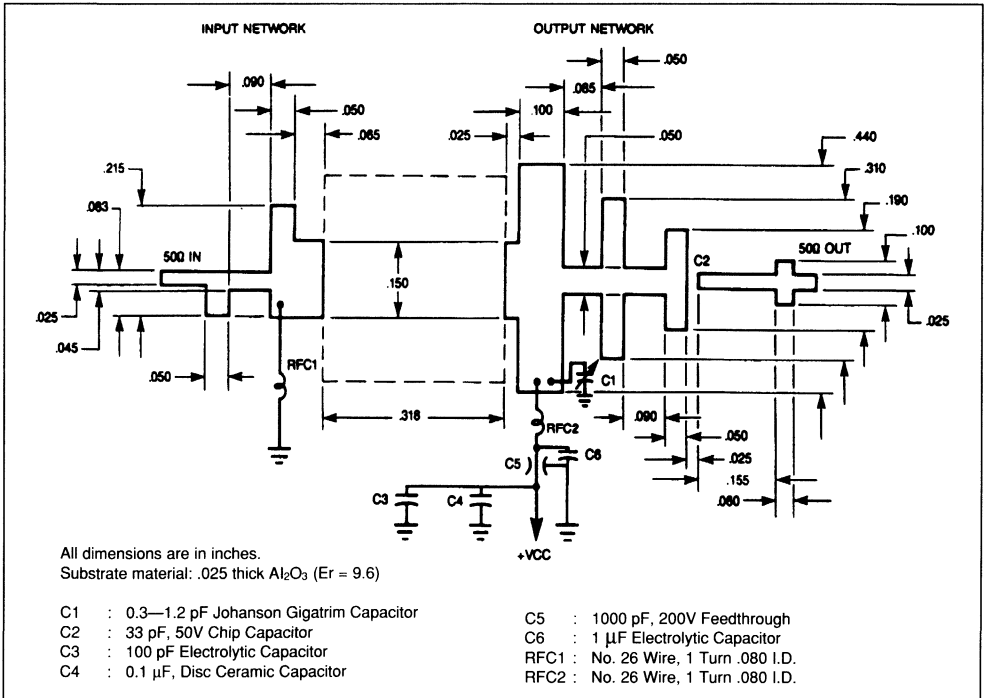


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 3.1 GHz	17.5 + j 14.5	13.5 - j 4.5
M = 3.3 GHz	13.5 + j 6.5	10.0 - j 6.0
H = 3.5 GHz	9.0 + j 4.5	6.5 - j 5.5

P<sub>IN</sub> = 6.25 W  
 V<sub>CC</sub> = 30 V  
 Normalized to 50 ohms

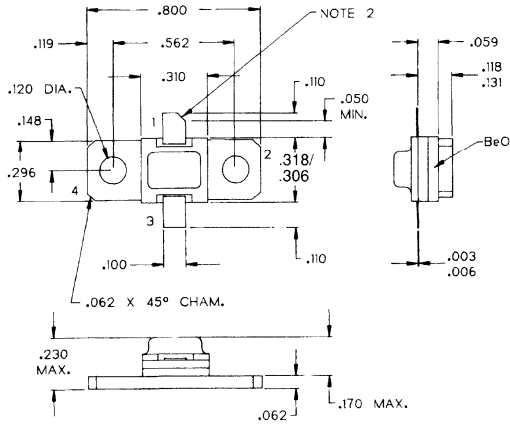


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133100D



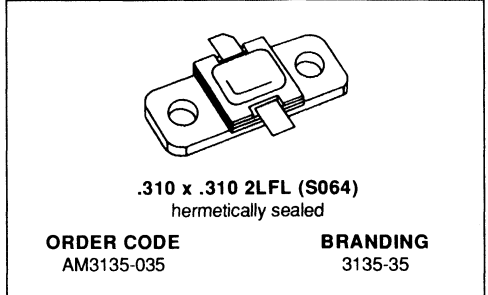
- NOTES:  
1. ALL TOLERANCE ± .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.  
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



## RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 35 \text{ W MIN. WITH } 6.0 \text{ dB GAIN}$

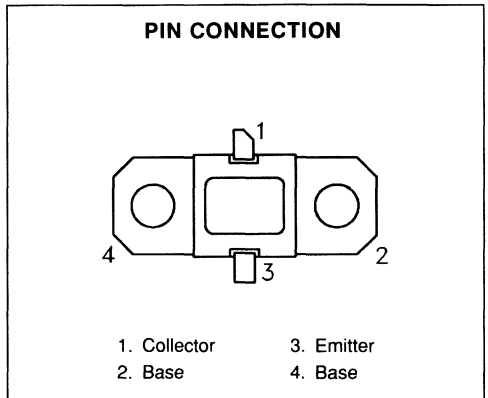


### DESCRIPTION

The AM3135-035 device is a high power silicon bipolar NPN transistor specifically designed for long pulse S-Band radar output and driver applications.

This device is characterized at 500  $\mu\text{sec}$  pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM3135-035 is supplied in the IMPACT™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^\circ\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^\circ\text{C}$ )	125	W
$I_c$	Device Current*	4.4	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^\circ\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^\circ\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.6	$^\circ\text{C/W}$
---------------	-----------------------------------	-----	--------------------

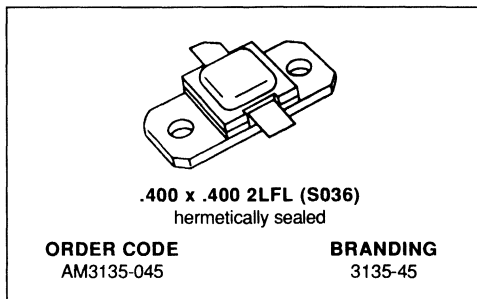
\*Applies only to rated RF amplifier operation



**RF & MICROWAVE TRANSISTORS  
S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

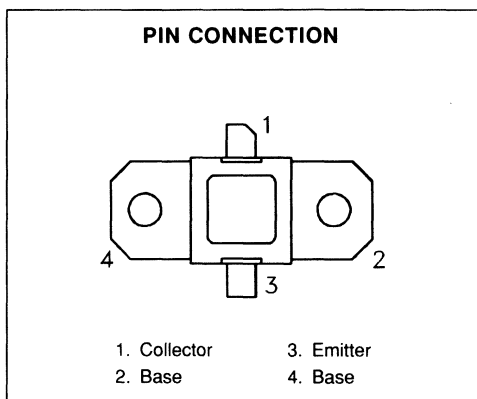
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 45 \text{ W MIN. WITH } 6.0 \text{ dB GAIN}$


**DESCRIPTION**

The AM3135-045 device is a high power silicon bipolar NPN transistor specifically designed for long pulse S-Band radar output and driver applications.

This device is characterized at 500  $\mu\text{sec}$  pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM3135-045 is supplied in the IMPACT™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}\text{C}$ )	150	W
$I_C$	Device Current*	5.0	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.33	$^{\circ}\text{C/W}$
---------------	-----------------------------------	------	----------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

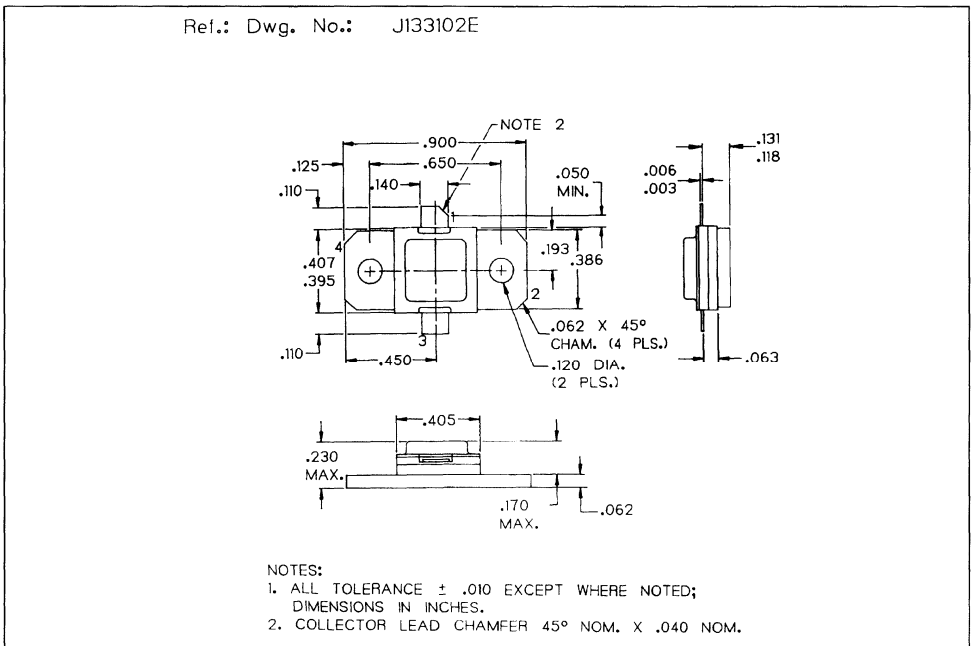
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 35mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 6mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 35mA$	$V_{BE} = 0V$	45	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 30V$	—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3.5A$	30	—	300	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3100 - 3500MHz$	$P_{IN} = 11.3W$	$V_{CC} = 30V$	45	—	—	W
$\eta_C$	$f = 3100 - 3500MHz$	$P_{IN} = 11.3W$	$V_{CC} = 30V$	35	—	—	%
$G_P$	$f = 3100 - 3500MHz$	$P_{IN} = 11.3W$	$V_{CC} = 30V$	6.0	—	—	dB

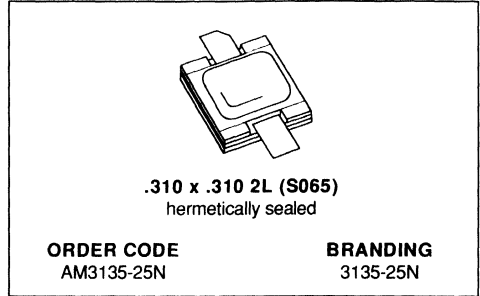
Note: Pulse Width = 500 $\mu$ Sec  
 Duty Cycle = 10%

**PACKAGE MECHANICAL DATA**



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

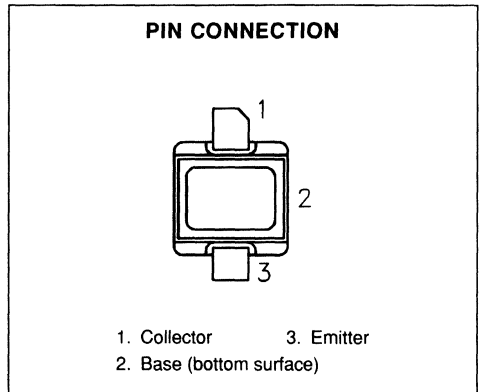
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY @ 1 dB OVERDRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 30 W MIN. WITH 6.8 dB GAIN


**DESCRIPTION**

The AM3135-25N device is a high power silicon bipolar NPN transistor specifically designed for long pulse S-Band radar output and driver applications.

This device is characterized at 500 μsec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM3135-25N is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 50°C)	100	W
I <sub>C</sub>	Device Current*	3.3	A
V <sub>CC</sub>	Collector-Supply Voltage*	34	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	2.0	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 20mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 4mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 20mA$	$V_{BE} = 0V$	45	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 30V$	—	—	15	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	30	—	—	—

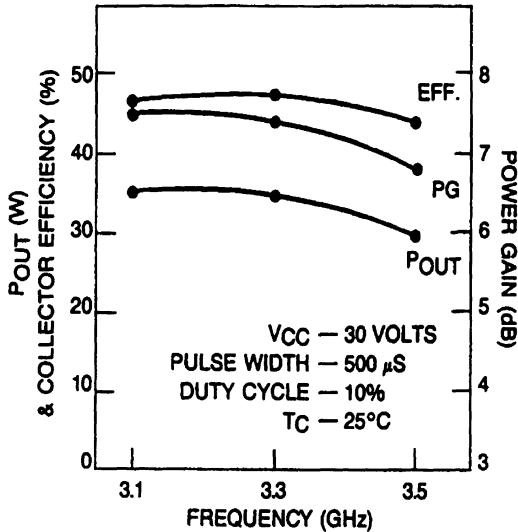
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.1 - 3.5GHz$	$P_{IN} = 6.25W$	$V_{CC} = 30V$	25	30	—	W
$\eta_C$	$f = 3.1 - 3.5GHz$	$P_{IN} = 6.25W$	$V_{CC} = 30V$	35	44	—	%
$G_P$	$f = 3.1 - 3.5GHz$	$P_{IN} = 6.25W$	$V_{CC} = 30V$	6.0	6.8	—	dB

Note: Pulse Width = 500  $\mu$ Sec  
 Duty Cycle = 10%

**TYPICAL PERFORMANCE**

**TYPICAL BROADBAND PERFORMANCE**



IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

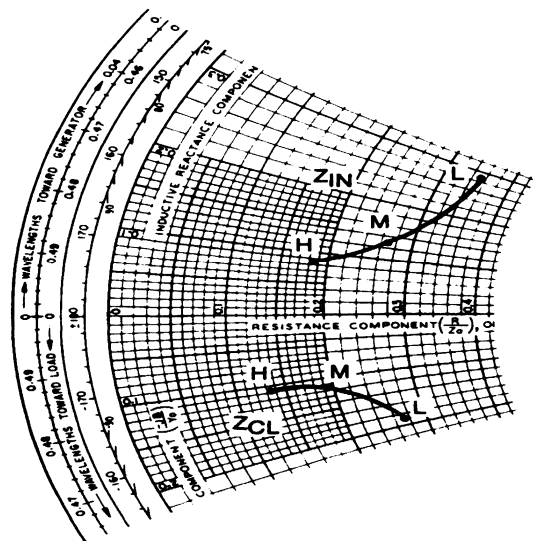


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 3.1 GHz	17.5 + j 14.5	13.5 - j 4.5
M = 3.3 GHz	13.5 + j 6.5	10.0 - j 6.0
H = 3.5 GHz	9.0 + j 4.5	6.5 - j 5.5

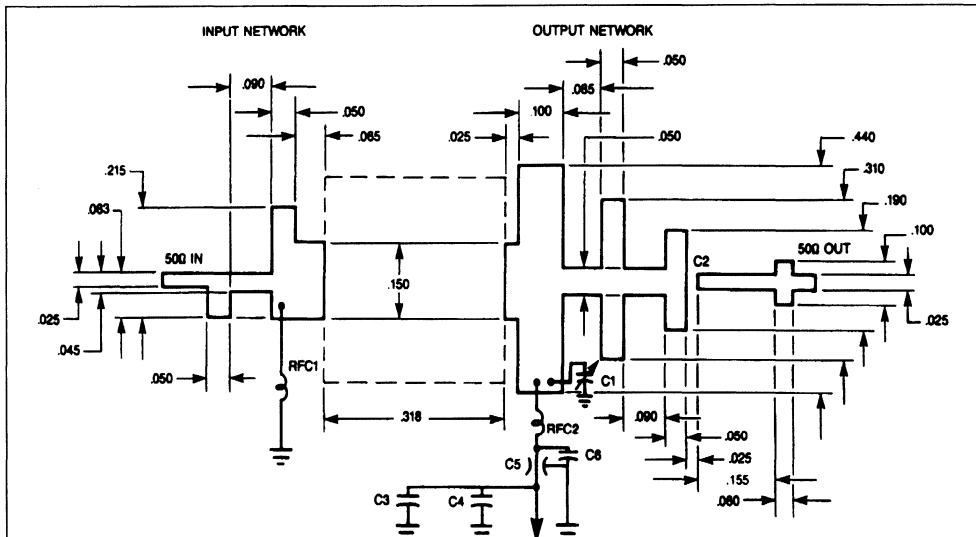
P<sub>IN</sub> = 6.25 W

V<sub>CC</sub> = 30 V

Normalized to 50 ohms



TEST CIRCUIT



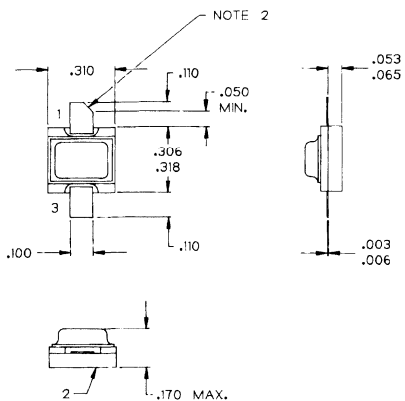
All dimensions are in inches.  
Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub> (Er = 9.6)

- C1 : 0.3—1.2 pF Johanson Gigatrim Capacitor
- C2 : 33 pF, 50V Chip Capacitor
- C3 : 100 pF Electrolytic Capacitor
- C4 : 0.1 μF, Disc Ceramic Capacitor

- C5 : 1000 pF, 200V Feedthrough
- C6 : 1 μF Electrolytic Capacitor
- RFC1 : No. 26 Wire, 1 Turn .080 I.D.
- RFC2 : No. 26 Wire, 1 Turn .080 I.D.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135062 A



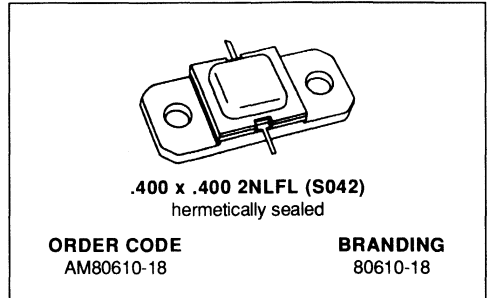
NOTES:

- 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
- 2. COLLECTOR LEAD CHAMFER  $45^\circ$  NOM. X  $.040$  NOM.



**RF & MICROWAVE TRANSISTORS  
 UHF COMMUNICATIONS APPLICATIONS**

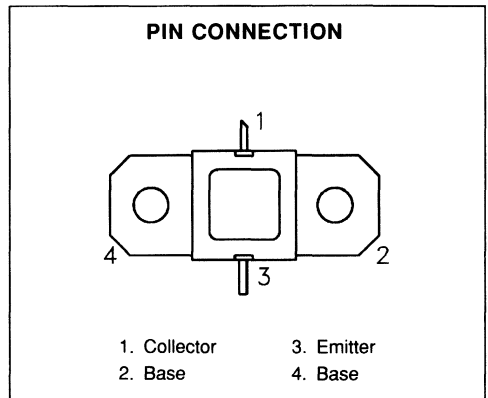
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 18$  W MIN. WITH 8.6 dB GAIN


**DESCRIPTION**

The AM80610-018 is a high power, common base NPN silicon bipolar device optimized for CW operation in the 620 - 960 MHz frequency range.

AM80610-018 utilizes a rugged, overlay, emitter-ballasted L-Band die geometry to achieve high gain and collector efficiency and is suitable for driver or output stage use in Class C power amplifiers. Typical applications include military communications, ECM, and test equipment.

The AM80610-018 is provided in the industry-standard, metal/ceramic AMPAC™ hermetic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	40	W
$I_c$	Device Current*	2.0	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	4.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

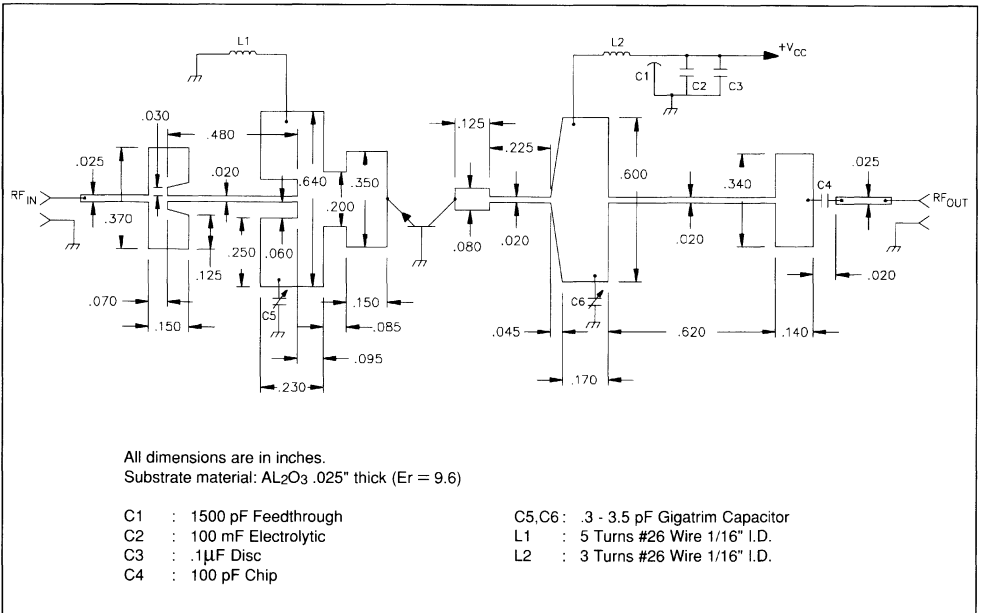
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 20mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 28V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	150	—

**DYNAMIC**

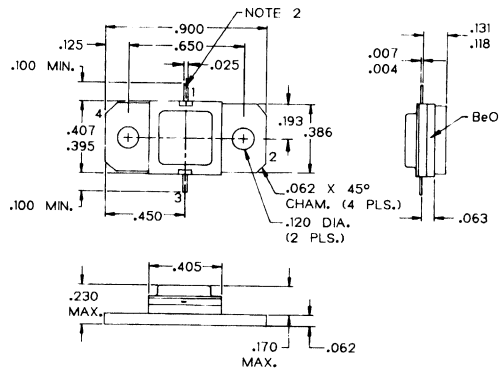
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 620 - 960MHz$	$P_{IN} = 2.5W$	$V_{CC} = 28V$	18	—	—	W
$\eta_c$	$f = 620 - 960MHz$	$P_{IN} = 2.5W$	$V_{CC} = 28V$	48	—	—	%
$G_P$	$f = 620 - 960MHz$	$P_{IN} = 2.5W$	$V_{CC} = 28V$	8.6	—	—	dB

**TEST CIRCUIT**



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



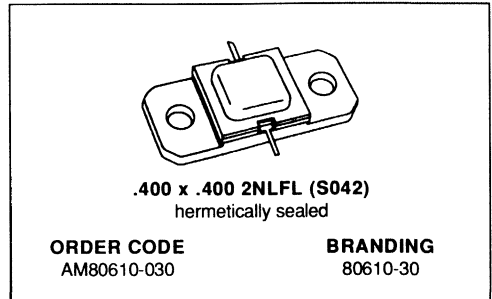
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 UHF COMMUNICATIONS APPLICATIONS**

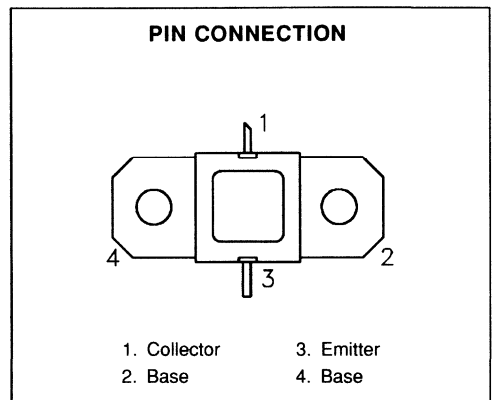
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- INPUT/OUTPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 30 W MIN. WITH 8.5 dB GAIN


**DESCRIPTION**

The AM80610-030 is a high power, common base NPN silicon bipolar device optimized for CW operation in the 620 - 960 MHz frequency range.

AM80610-030 utilizes a rugged, overlay, emitter-ballasted L-Band die geometry to achieve high gain and collector efficiency and is suitable for driver or output stage use in Class C power amplifiers. Typical applications include military communications, ECM, and test equipment.

The Am80610-030 is provided in the industry-standard, metal/ceramic AMPAC™ hermetic package.


**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 50°C)	57	W
I <sub>C</sub>	Device Current*	3.0	A
V <sub>CC</sub>	Collector-Supply Voltage*	32	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	2.6	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

# AM80610-030

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

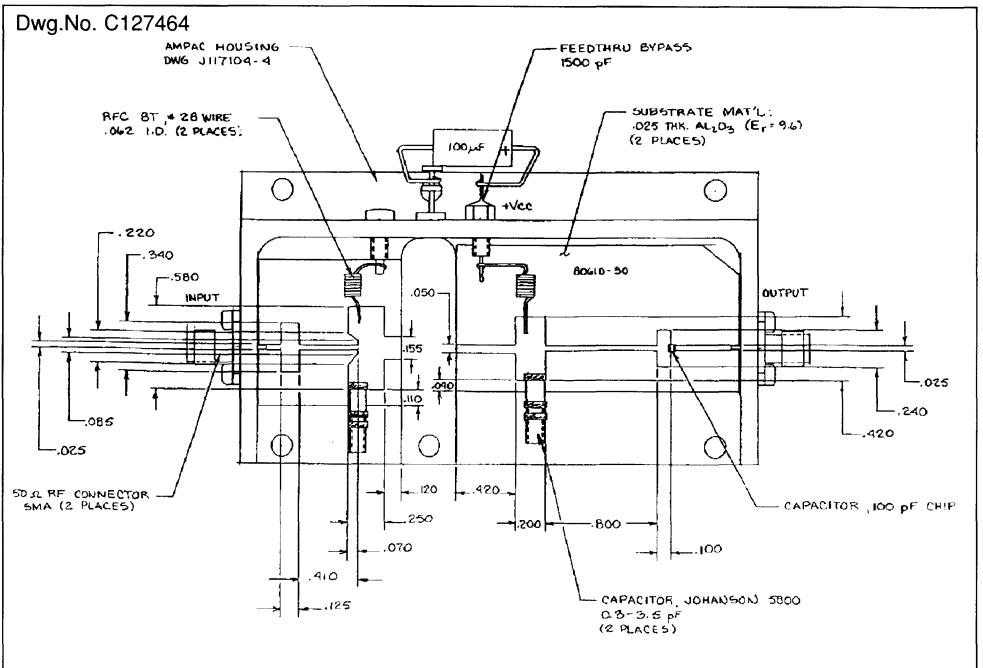
### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 20mA	I <sub>E</sub> = 0mA	55	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 2mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 40mA	R <sub>BE</sub> = 10Ω	55	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 28V	—	—	10	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 2A	15	—	150	—

### DYNAMIC

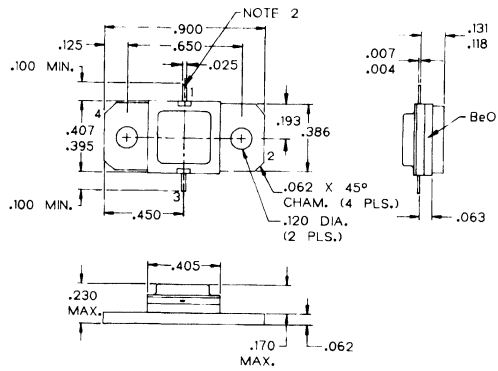
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 620 — 960MHz	P <sub>IN</sub> = 4.2W	V <sub>CC</sub> = 28V	30	—	—	W
η <sub>c</sub>	f = 620 — 960MHz	P <sub>IN</sub> = 4.2W	V <sub>CC</sub> = 28V	50	—	—	%
G <sub>p</sub>	f = 620 — 960MHz	P <sub>IN</sub> = 4.2W	V <sub>CC</sub> = 28V	8.5	—	—	dB

### TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

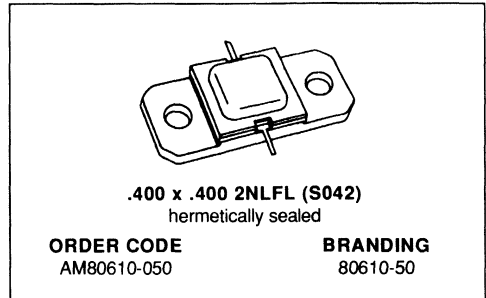
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.





**RF & MICROWAVE TRANSISTORS  
 UHF COMMUNICATIONS APPLICATIONS**

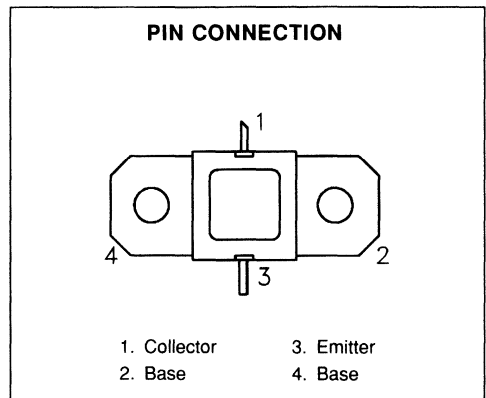
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 50 \text{ W MIN. WITH } 8.5 \text{ dB GAIN}$


**DESCRIPTION**

The AM80610-050 is a high power, common base NPN silicon bipolar device optimized for CW operation in the 750 - 960 MHz frequency range.

AM80610-050 utilizes a rugged, overlay, emitter-ballasted L-Band die geometry to achieve high gain and collector efficiency and is suitable for driver or output stage use in Class C power amplifiers. Typical applications include military communications, ECM, and test equipment.

The AM80610-050 is provided in the industry-standard, Metal/Ceramic AMPAC™ Hermetic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}\text{C}$ )	83	W
$I_c$	Device Current*	5.0	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.8	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

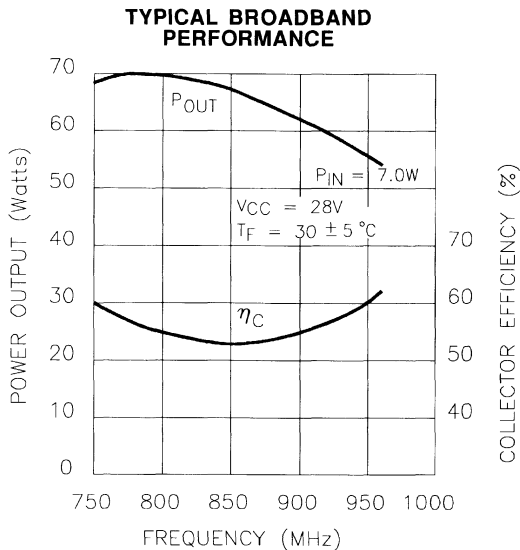
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 30mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 3mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 60mA$	$V_{BE} = 0V$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 28V$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	15	—	—	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 750 - 960MHz$	$P_{IN} = 7.0W$	$V_{CC} = 28V$	50	—	—	W
$\eta_C$	$f = 750 - 960MHz$	$P_{IN} = 7.0W$	$V_{CC} = 28V$	50	—	—	%
$G_P$	$f = 750 - 960MHz$	$P_{IN} = 7.0W$	$V_{CC} = 28V$	8.5	—	—	dB

TYPICAL PERFORMANCE

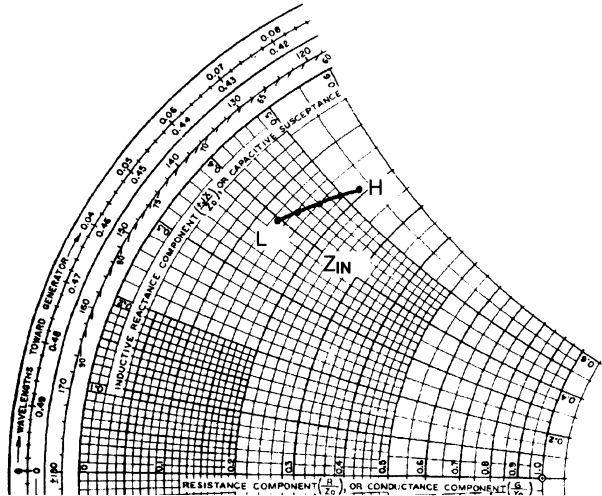


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

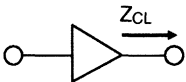


$P_{IN} = 7.0W$   
 $V_{CC} = 28V$   
 Normalized to 50 Ohms

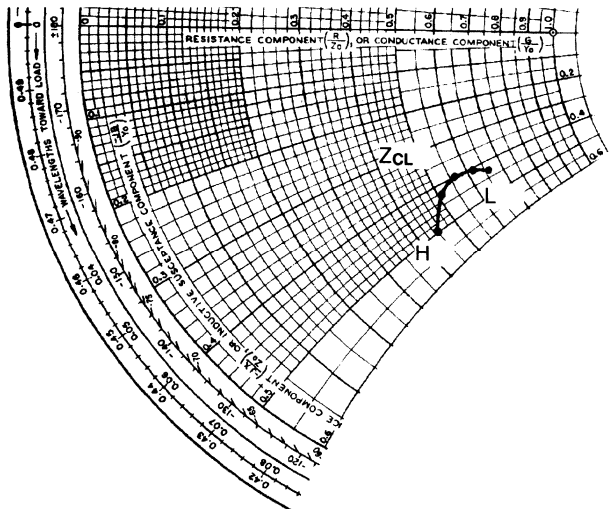


FREQ.	$Z_{IN}(\Omega)$	$Z_{CL}(\Omega)$
L = 600 MHz	$6.5 + j 19.8$	$33.0 - j 21.5$
• = 700 MHz	$7.0 + j 21.3$	$31.0 - j 20.5$
M = 800 MHz	$8.0 + j 23.0$	$28.0 - j 20.0$
• = 900 MHz	$8.9 + j 24.5$	$25.2 - j 21.0$
H = 1000 MHz	$9.5 + j 26.5$	$22.5 - j 25.0$

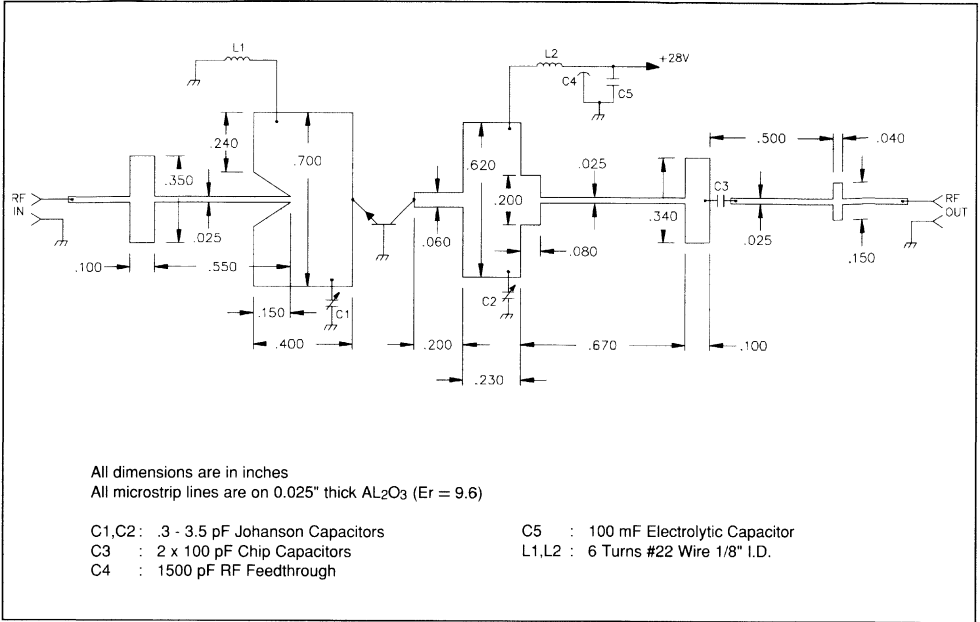
TYPICAL COLLECTOR LOAD IMPEDANCE



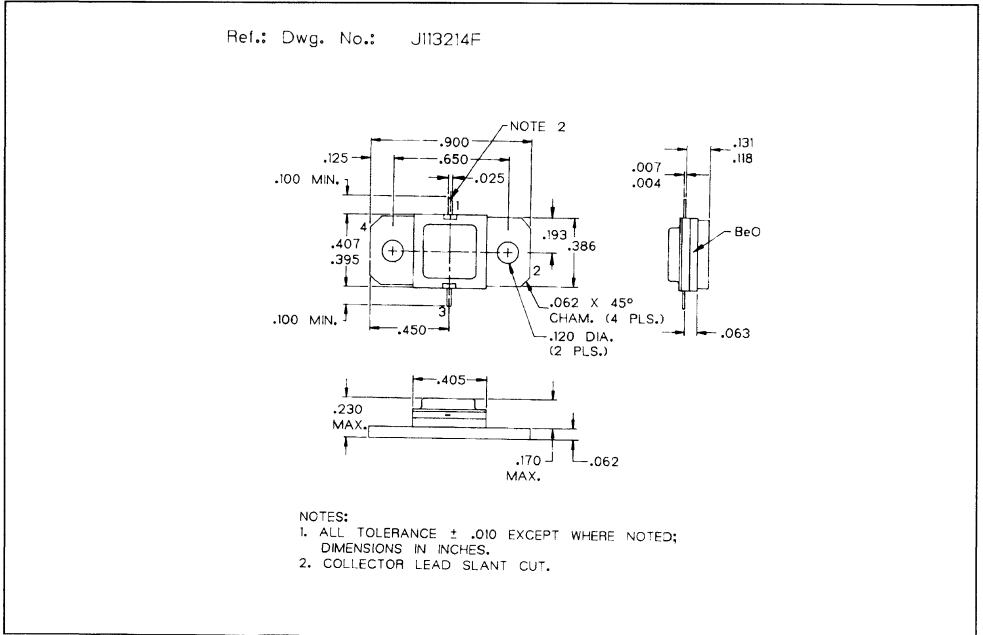
$P_{IN} = 7.0W$   
 $V_{CC} = 28V$   
 Normalized to 50 Ohms



TEST CIRCUIT

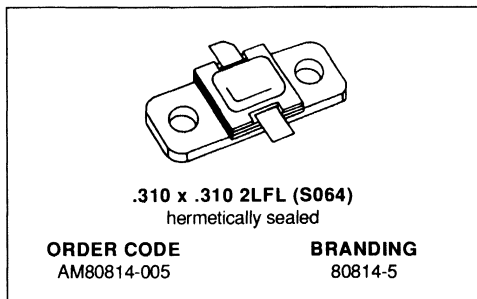


PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

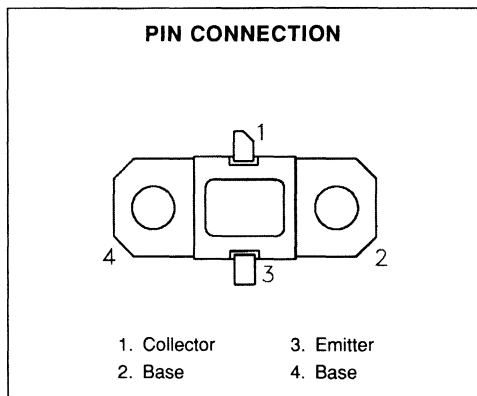
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 5.0 \text{ W MIN. WITH } 8.5 \text{ dB GAIN}$


**DESCRIPTION**

The AM80814-005 device is a high power Class C transistor specifically designed for L-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding 5:1 output VSWR at rated RF conditions. Low thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM80814-005 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}\text{C}$ )	23	W
$I_c$	Device Current*	1.0	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	6.5	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	48	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	48	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 28V$	—	—	500	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	30	—	300	—

DYNAMIC

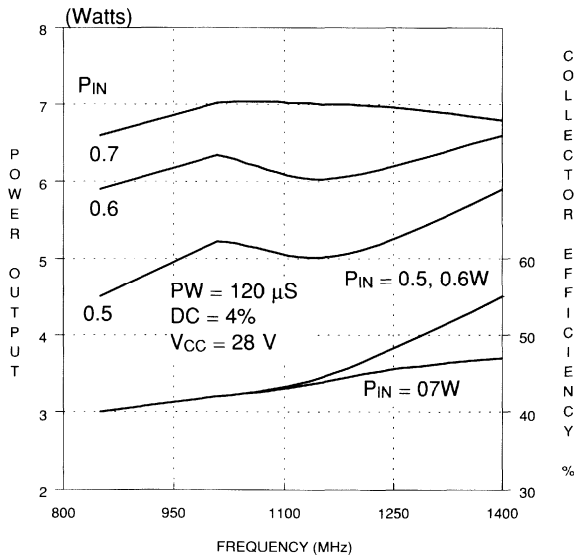
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 850 - 1400MHz$	$P_{IN} = 0.7W$	$V_{CC} = 28V$	5.0	5.7	—	W
$\eta_C$	$f = 850 - 1400MHz$	$P_{IN} = 0.7W$	$V_{CC} = 28V$	35	40	—	%
GP	$f = 850 - 1400MHz$	$P_{IN} = 0.7W$	$V_{CC} = 28V$	8.5	9.0	—	dB

Note: Pulse Width = 120µS

Duty Cycle = 4%

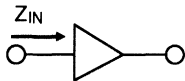
**TYPICAL PERFORMANCE**

**POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**

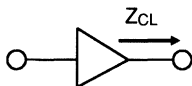


IMPEDANCE DATA

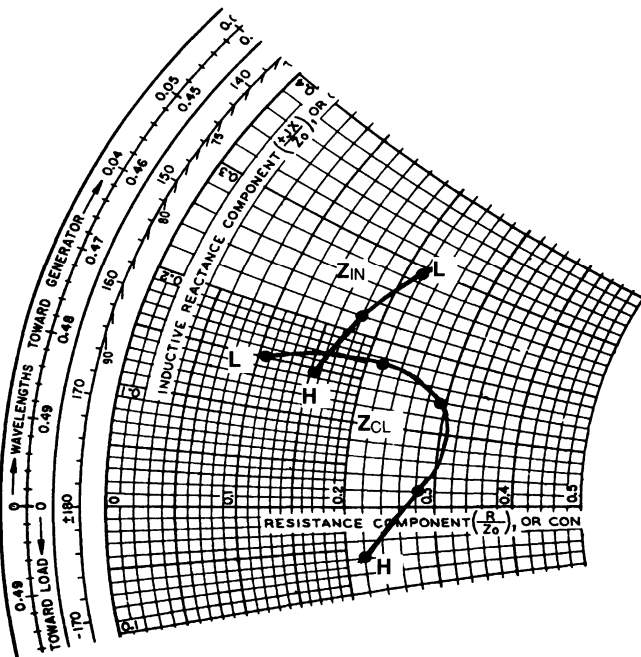
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

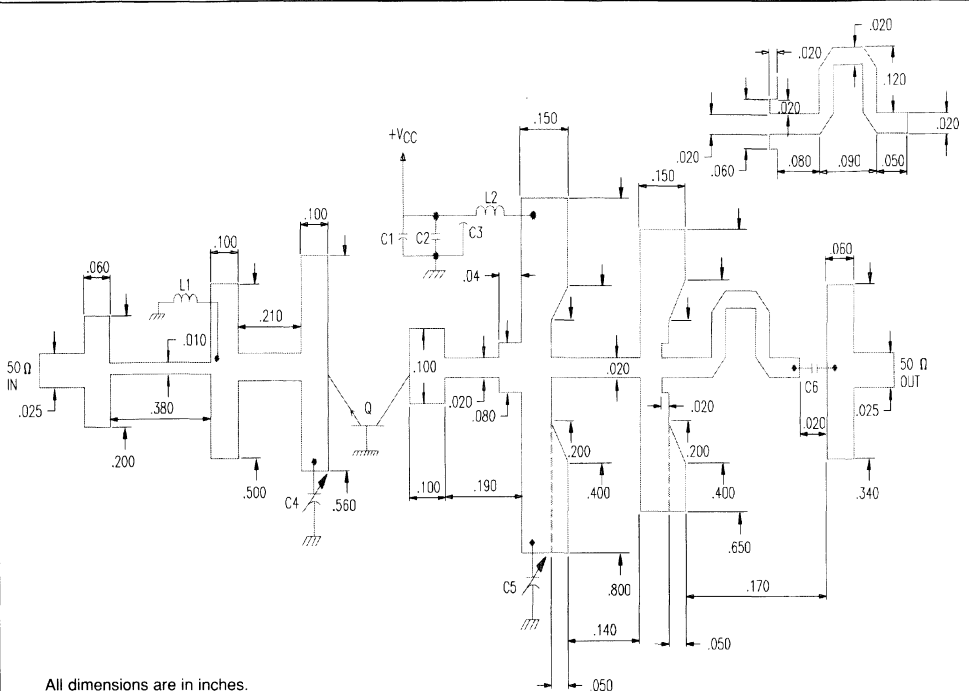


$P_{IN} = 0.7 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 Normalized to 50 ohms



FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 0.85 GHz	$0.22 + j 0.29$	$0.13 + j 0.15$
• = 1.0 GHz	$0.21 + j 0.25$	$0.18 + j 0.18$
• = 1.1 GHz	$0.19 + j 0.22$	$0.23 + j 0.17$
• = 1.2 GHz	$0.18 + j 0.17$	$0.32 + j 0.16$
• = 1.3 GHz	$0.17 + j 0.15$	$0.29 + j 0.02$
H = 1.4 GHz	$0.16 + j 0.14$	$0.22 - j 0.06$

TEST CIRCUIT



All dimensions are in inches.  
Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub>

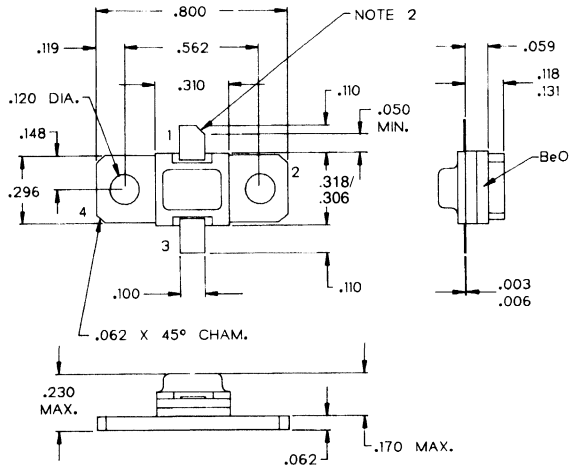
- C1 : 100  $\mu$ F Electrolytic Capacitor, 63V
- C2 : .1  $\mu$ F Ceramic Capacitor
- C3 : Feedthrough Bypass SC1 712-022
- C4 : .6 — 4.5 pF, 2 pls, Johanson Gigatrim Capacitor

- C5 : .6 — 4.5 pF, 2 pls, Johanson Gigatrim Capacitor
- C6 : 100 pF Chip Capacitor
- L1 : No. 26 Wire, 4 Turn
- L2 : No. 26 Wire, 4 Turn



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133100D



NOTES:

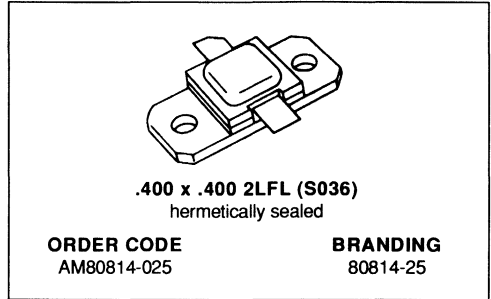
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

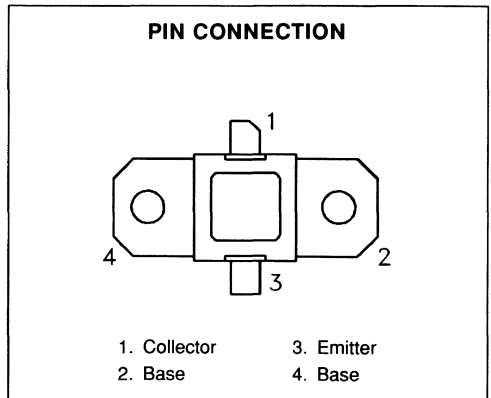
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 25$  W MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

AM80814-025 is a high power silicon Class C transistor designed for ultra-broadband L-Band radar applications.

This device is capable of operation over a broad range of pulse widths and duty cycles. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

AM80814-025 is supplied in the industry-standard AMPAC™ hermetic Metal/Ceramic package incorporating Input/Output impedance matching.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 75^{\circ}C$ )	75	W
$I_C$	Device Current*	3.5	A
$V_{CC}$	Collector-Supply Voltage*	38	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.3	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

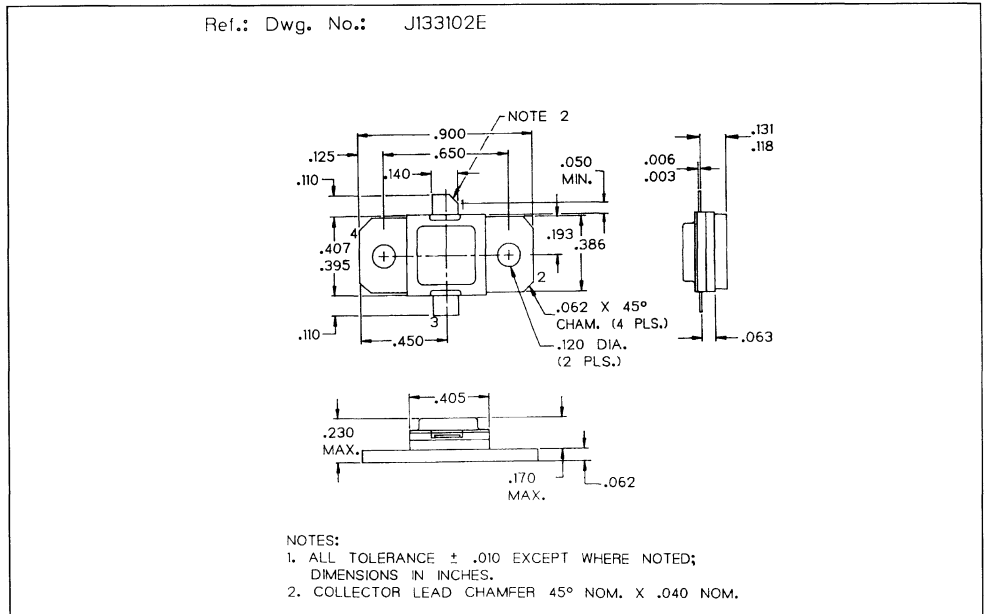
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 20mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 28V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	150	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 850 - 1400MHz$	$P_{IN} = 5.0W$	$V_{CC} = 35V$	25	—	—	W
$\eta_C$	$f = 850 - 1400MHz$	$P_{IN} = 5.0W$	$V_{CC} = 35V$	38	—	—	%
GP	$f = 850 - 1400MHz$	$P_{IN} = 5.0W$	$V_{CC} = 35V$	7.0	—	—	dB

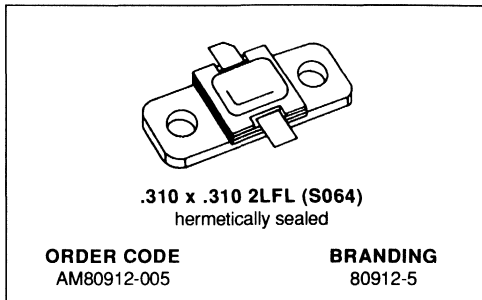
Note: Pulse Width = 120µS  
 Duty Cycle = 4%

**PACKAGE MECHANICAL DATA**



## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

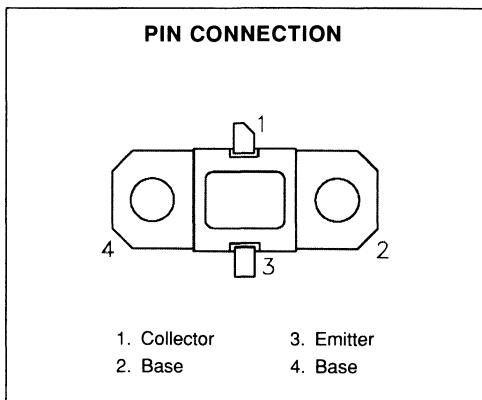
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 6.0 W MIN. WITH 9.3 dB GAIN



### DESCRIPTION

The AM80912-005 is designed for specialized avionics applications, including JTIDS, where power is provided under pulse formats utilizing short pulse widths and high burst or overall duty cycles.

The AM80912-005 is housed in the unique IMPAC™ Hermetic Metal/Ceramic package with internal input impedance matching.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 75°C)	25	W
I <sub>c</sub>	Device Current*	0.9	A
V <sub>CC</sub>	Collector-Supply Voltage*	32	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	7.0	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$	48	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$BV_{\text{CER}}$	$I_{\text{C}} = 5\text{mA}$	$R_{\text{BE}} = 10\Omega$	48	—	—	V
$I_{\text{CES}}$	$V_{\text{BE}} = 0\text{V}$	$V_{\text{CE}} = 28\text{V}$	—	—	0.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 250\text{mA}$	30	—	300	—

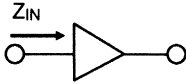
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 960 \text{ — } 1215\text{MHz}$	$P_{\text{IN}} = 0.7\text{W}$	$V_{\text{CC}} = 28\text{V}$	6.0	—	—	W
$\eta_{\text{C}}$	$f = 960 \text{ — } 1215\text{MHz}$	$P_{\text{IN}} = 0.7\text{W}$	$V_{\text{CC}} = 28\text{V}$	45	—	—	%
$G_{\text{P}}$	$f = 960 \text{ — } 1215\text{MHz}$	$P_{\text{IN}} = 0.7\text{W}$	$V_{\text{CC}} = 28\text{V}$	9.3	—	—	dB

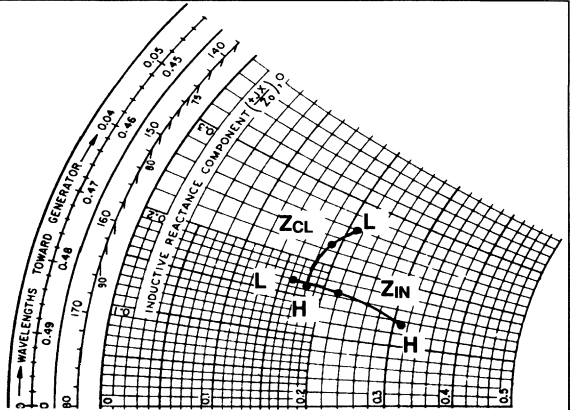
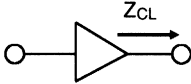
Note: Pulse format: 6.4  $\mu\text{S}$  on 6.6  $\mu\text{S}$  off, repeat for 3.3 ms, then off for 4.5125 ms.  
Duty Cycle: Burst 49.2%, overall 20.8%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



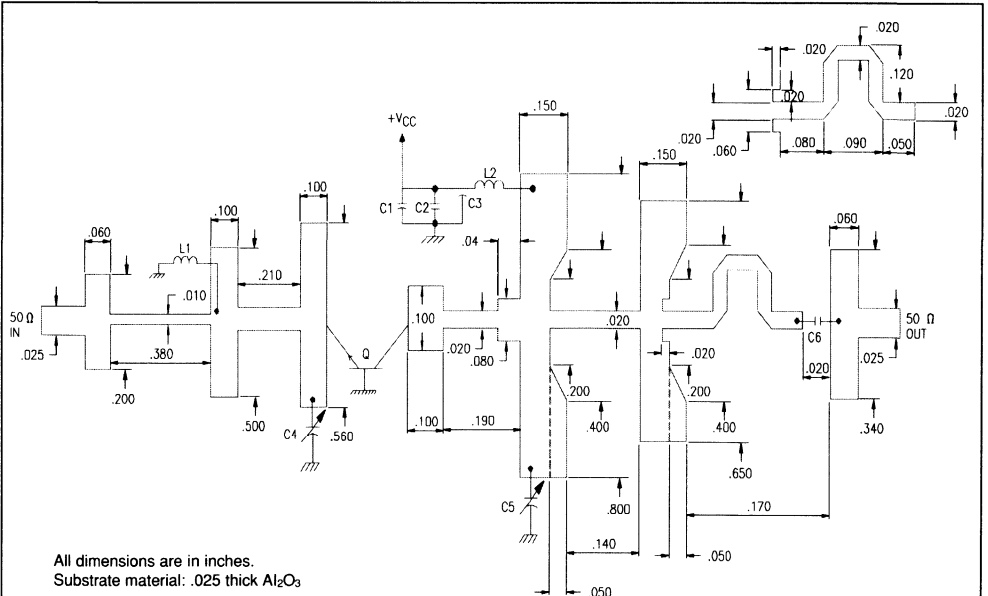
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 960 MHz	8.2 + j 8.52	10.5 + j 12.9
M = 1090 MHz	11.1 + j 8.34	9.4 + j 11.3
H = 1215 MHz	15.6 + j 6.8	9.0 + j 8.3

P<sub>IN</sub> = 0.7 W  
 V<sub>CC</sub> = 28 V  
 Normalized to 50 ohms

TEST CIRCUIT



All dimensions are in inches.  
 Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub>

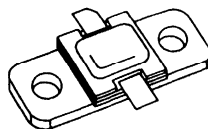
- C1 : 100 μF Electrolytic Capacitor, 63V
- C2 : .1 μF Ceramic Capacitor
- C3 : Feedthrough Bypass SCI 712-022
- C4 : .6 — 4.5 pF, 2 pls, Johanson Gigatrim Capacitor
- C5 : .6 — 4.5 pF, 2 pls, Johanson Gigatrim Capacitor
- C6 : 100 pF Chip Capacitor
- L1 : No. 26 Wire, 4 Turn
- L2 : No. 26 Wire, 4 Turn





## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- ∞:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 15 W MIN. WITH 8.1 dB GAIN
- BANDWIDTH 255 MHz



**.310 x .310 2LFL (S064)**  
hermetically sealed

**ORDER CODE**  
AM80912-015

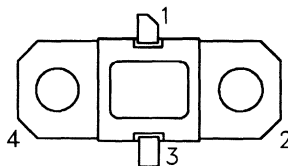
**BRANDING**  
80912-15

### DESCRIPTION

The AM80912-015 is designed for specialized avionics applications, including JTIDS, where power is provided under pulse formats utilizing short pulse widths and high burst or overall duty cycles.

The AM80912-015 is housed in the unique IMPAC™ Hermetic Metal/Ceramic package with internal input impedance matching.

### PIN CONNECTION



- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	50	W
I <sub>C</sub>	Device Current*	1.8	A
V <sub>CC</sub>	Collector-Supply Voltage*	32	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	3.0	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 10\text{mA}$	$I_{\text{E}} = 0\text{mA}$	55	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$BV_{\text{CER}}$	$I_{\text{C}} = 10\text{mA}$	$R_{\text{BE}} = 10\Omega$	55	—	—	V
$I_{\text{CES}}$	$V_{\text{BE}} = 0\text{V}$	$V_{\text{CE}} = 28\text{V}$	—	—	2.0	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 500\text{mA}$	15	—	150	—

## DYNAMIC

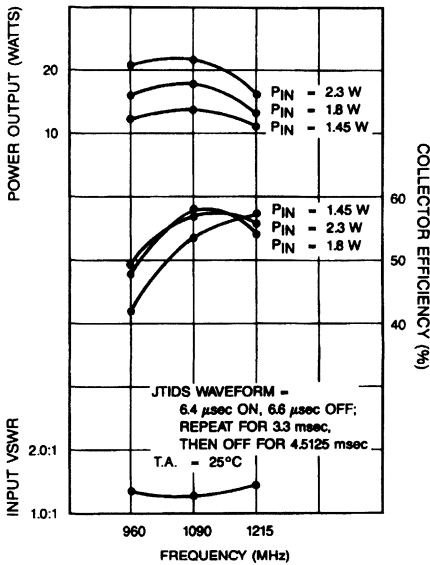
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 960 - 1215\text{MHz}$	$P_{\text{IN}} = 2.3\text{W}$	$V_{\text{CC}} = 28\text{V}$	15	17	—	W
$\eta_{\text{C}}$	$f = 960 - 1215\text{MHz}$	$P_{\text{IN}} = 2.3\text{W}$	$V_{\text{CC}} = 28\text{V}$	45	49	—	%
$G_{\text{P}}$	$f = 960 - 1215\text{MHz}$	$P_{\text{IN}} = 2.3\text{W}$	$V_{\text{CC}} = 28\text{V}$	8.1	8.9	—	dB

Note: Pulse format: 6.4  $\mu\text{S}$  on 6.6  $\mu\text{S}$  off, repeat for 3.3 ms, then off for 4.5125 ms.

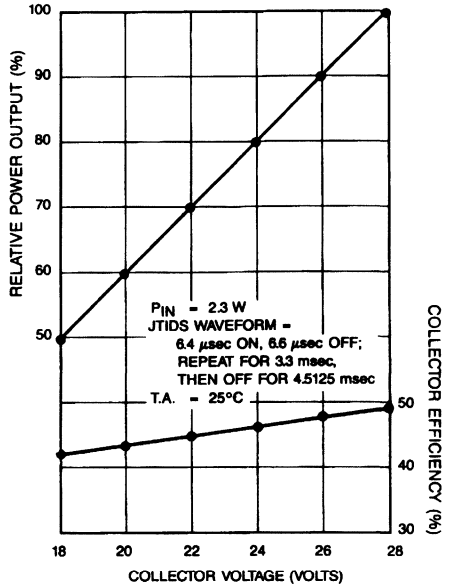
Duty Cycle: Burst 49.2%, overall 20.8%

TYPICAL PERFORMANCE

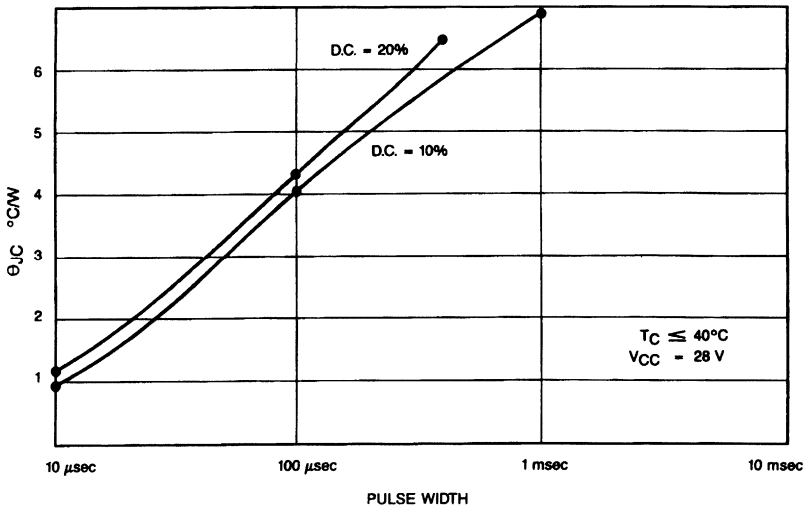
TYPICAL BROADBAND POWER AMPLIFIER



RELATIVE POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE

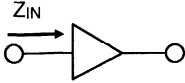


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

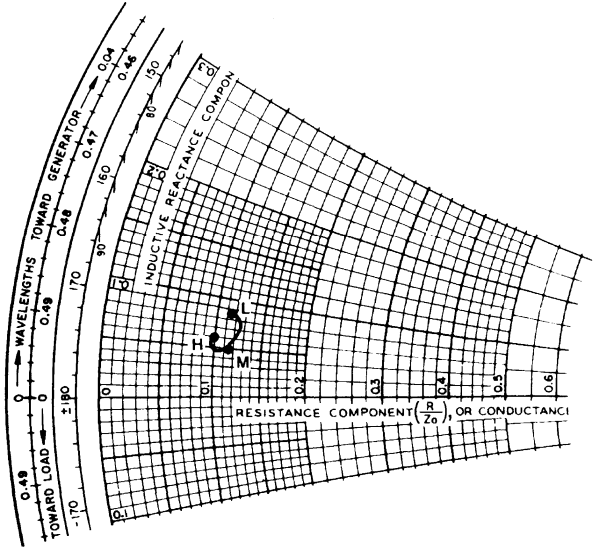


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

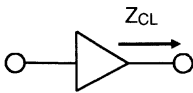


$P_{IN} = 2.3 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 $Z_{O^*} = 50 \text{ ohms}$

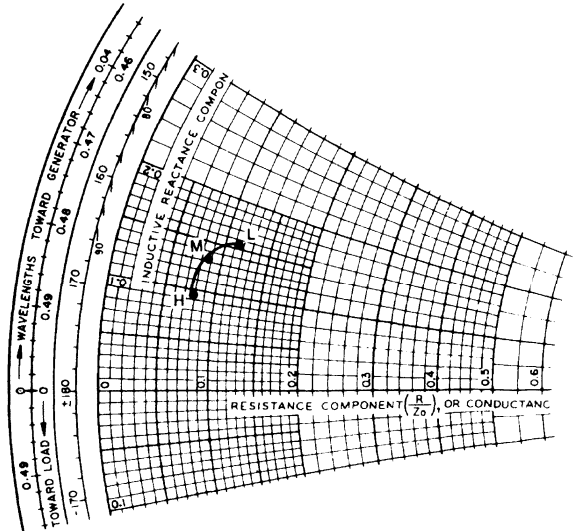


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 960 MHz	$5.7 + j 4.3$	$5.7 + j 7.7$
M = 1090 MHz	$5.8 + j 2.5$	$4.3 + j 6.5$
H = 1215 MHz	$5.0 + j 3.0$	$4.0 + j 4.8$

TYPICAL COLLECTOR LOAD IMPEDANCE



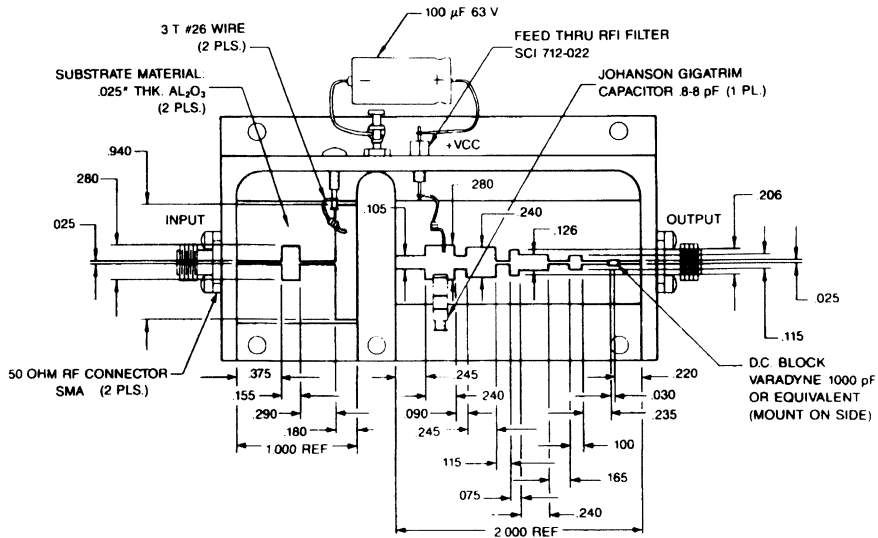
$P_{IN} = 2.3 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 $Z_{O^*} = 50 \text{ ohms}$



\*Normalized Impedance

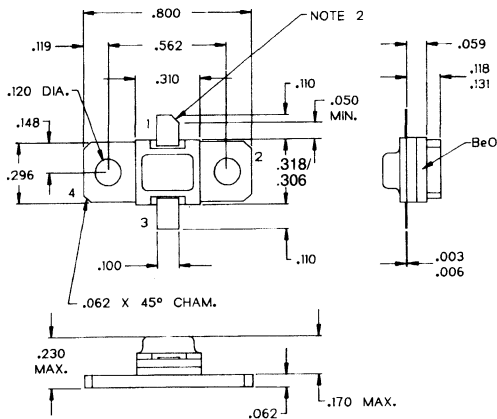
TEST CIRCUIT

Ref.: Dwg. No. 104-000284



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133100D

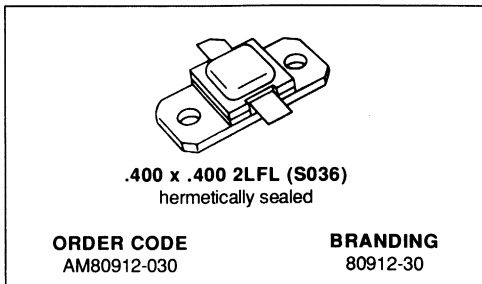


- NOTES:  
 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
 DIMENSIONS IN INCHES.  
 2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



## RF & MICROWAVE TRANSISTORS SPECIALITY AVIONICS/JTIDS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 15:1 VSWR CAPABILITY
- LOW RF THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 30 \text{ W MIN. WITH } 7.8 \text{ dB GAIN}$



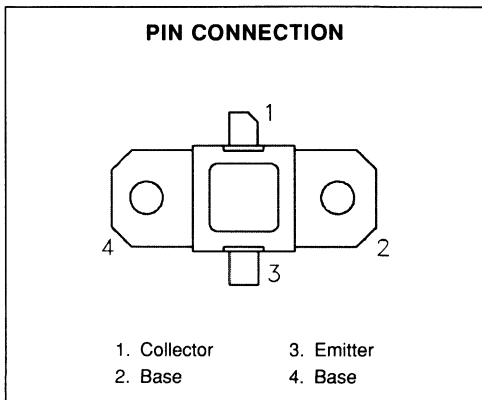
### DESCRIPTION

The AM80912-030 device is a high power Class C transistor specifically designed for JTIDS pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding 15:1 output VSWR at rated RF conditions.

Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM80912-030 is supplied in the hermetic metal/ceramic package with internal input matching structures.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 85^{\circ}\text{C}$ )	75	W
$I_C$	Collector Current*	3.5	A
$V_{CC}$	Collector-Supply Voltage*	40	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.2	$^{\circ}\text{C}/\text{W}$
---------------	----------------------------------	-----	-----------------------------

\*Applies only to rated RF amplifier operation.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	55	—	—	V
$BV_{EBO}$	$I_E = 1mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 20mA$ $R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{CE} = 35V$	—	—	5.0	mA
$h_{FE}$	$V_{CE} = 5V$ $I_C = 1.0A$	15	—	150	—

**DYNAMIC**

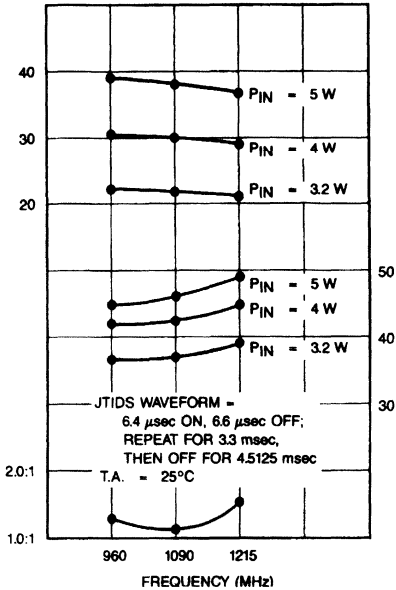
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$P_{OUT}$	$f = 960 - 1215MHz$ $P_{IN} = 5.0W$ $V_{CC} = +35V$	30	36	—	W
$\eta_C$	$f = 960 - 1215MHz$ $P_{IN} = 5.0W$ $V_{CC} = +35V$	40	45	—	%
GP	$f = 960 - 1215MHz$ $P_{IN} = 5.0W$ $V_{CC} = +35V$	7.8	8.6	—	dB

Note: Pulse format: 6.4  $\mu s$  on 6.6  $\mu s$  off, repeat for 3.3 ms, then off for 4.5125 ms.  
 Duty Cycle: Burst 49.2%, overall 20.8%

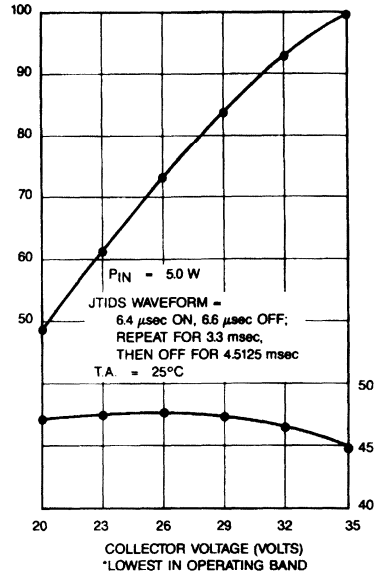


TYPICAL PERFORMANCE

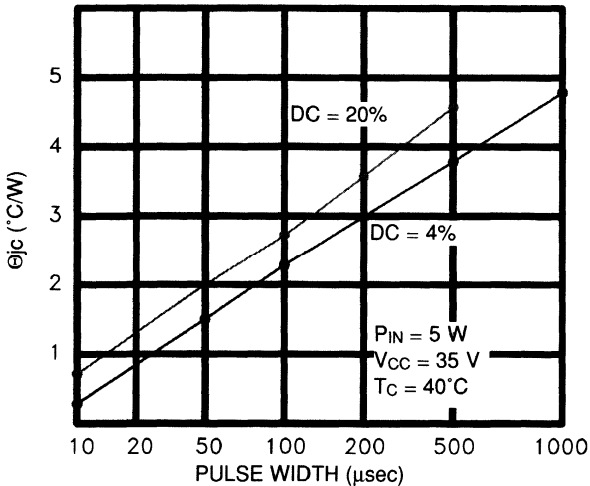
TYPICAL BROADBAND POWER AMPLIFIER



TYPICAL RELATIVE POWER OUTPUT & COLLECTOR VOLTAGE EFFICIENCY\* vs COLLECTOR VOLTAGE

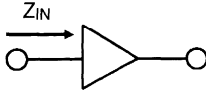


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

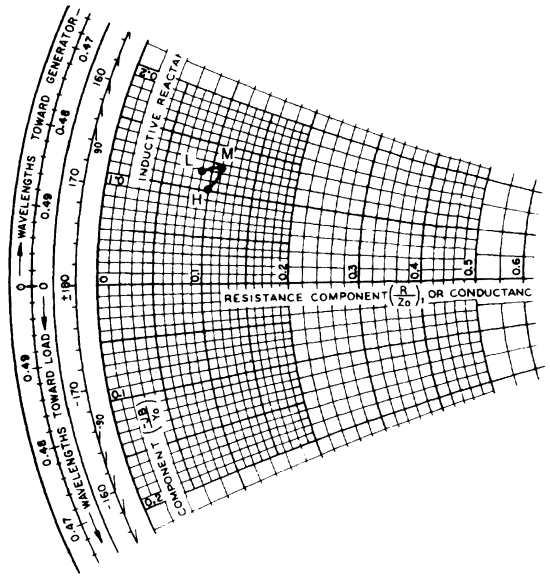


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

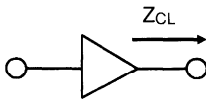


$P_{IN} = 5W$   
 $V_{CC} = +35V$   
 $Z_{O^*} = 50\Omega$

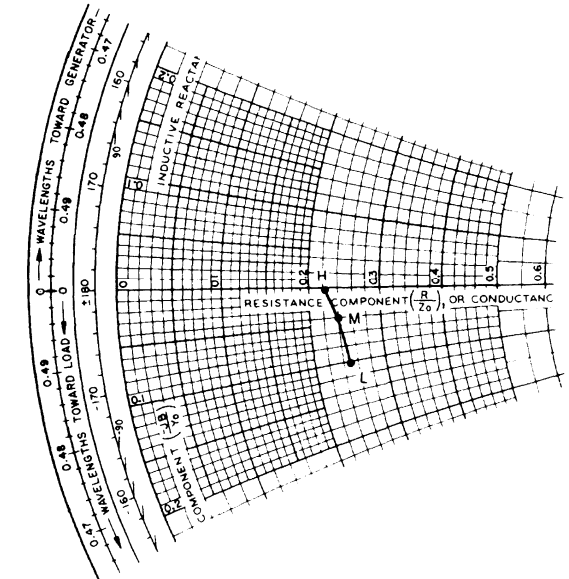


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 960 MHz	$4.5 + j 6.0$	$11.0 - j 0.5$
M = 1090 MHz	$5.5 + j 6.3$	$12.0 - j 2.0$
H = 1215 MHz	$5.0 + j 5.0$	$12.5 - j 5.0$

TYPICAL COLLECTOR LOAD IMPEDANCE

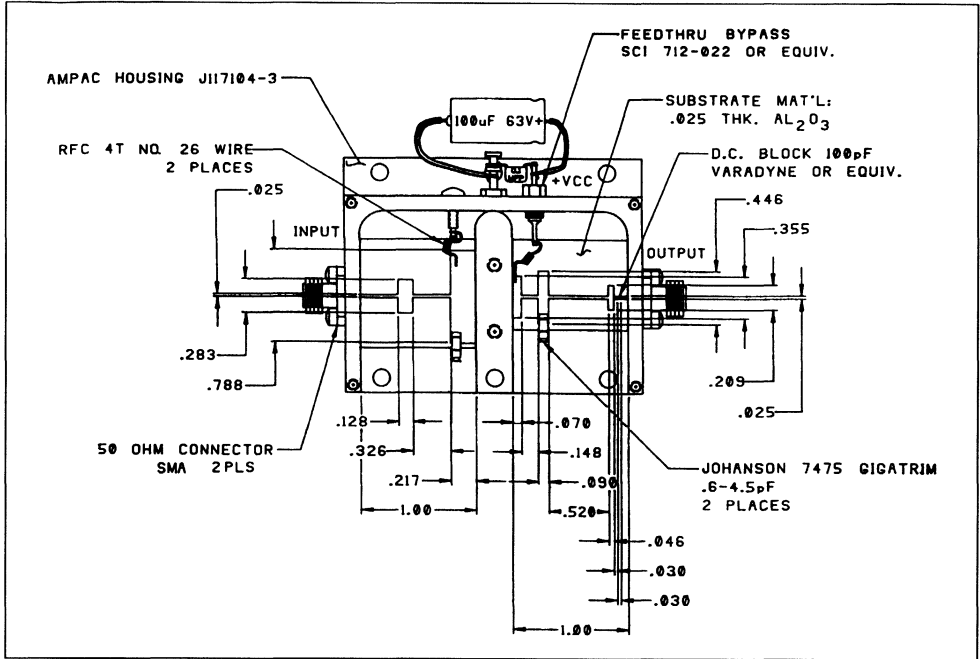


$P_{IN} = 5W$   
 $V_{CC} = +35V$   
 $Z_{O^*} = 50\Omega$

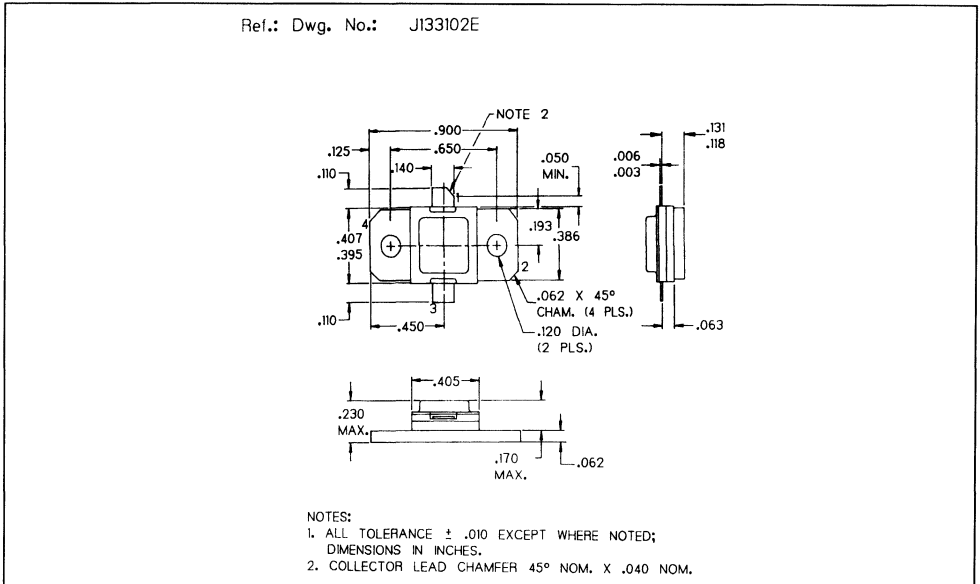


\*Normalized Impedance

TEST CIRCUIT



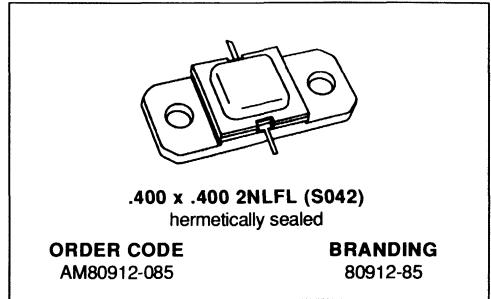
PACKAGE MECHANICAL DATA





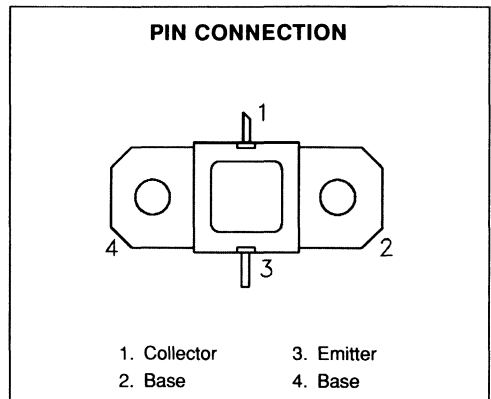
**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 85 W MIN. WITH 7.5 dB GAIN


**DESCRIPTION**

The AM80912-085 is designed for specialized avionics applications including JTIDS, where power is provided under pulse formats utilizing short pulse widths and high burst or overall duty cycles.

The AM80912-085 is housed in a unique BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching.


**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 100°C)	300	W
I <sub>c</sub>	Device Current*	8.0	A
V <sub>CC</sub>	Collector-Supply Voltage*	40	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.75	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 35V$	—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	20	—	200	—

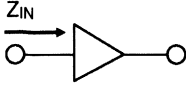
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 960 - 1215MHz$	$P_{IN} = 15W$	$V_{CC} = 35V$	85	—	—	W
$\eta_C$	$f = 960 - 1215MHz$	$P_{IN} = 15W$	$V_{CC} = 35V$	40	—	—	%
$G_P$	$f = 960 - 1215MHz$	$P_{IN} = 15W$	$V_{CC} = 35V$	7.5	—	—	dB

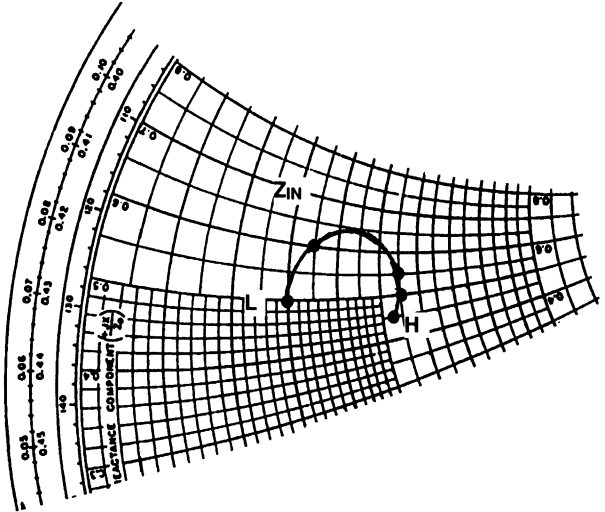
Note: Pulse format: 6.4  $\mu S$  on 6.6  $\mu S$  off, repeat for 3.3 ms, then off for 4.5125 ms  
 Duty Cycle: Burst 49.2%, overall 20.8%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

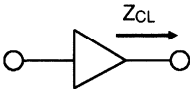


$P_{IN} = 15\text{ W}$   
 $V_{CC} = 35\text{ V}$   
 Normalized to 10 ohms

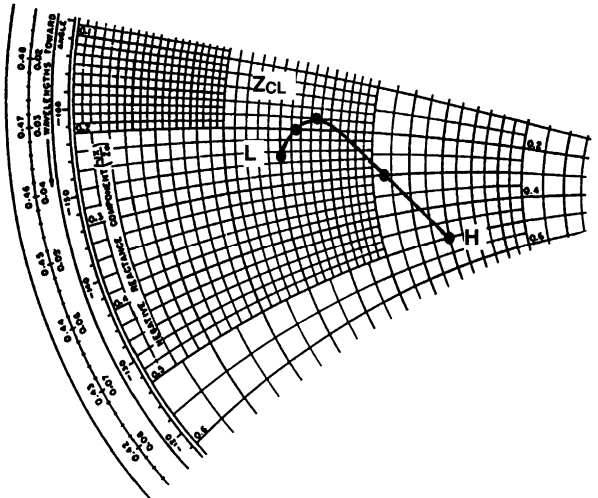


FREQ.	$Z_{IN}(\Omega)$	$Z_{CL}(\Omega)$
L = 960 MHz	$3.0 + j 5.0$	$7.0 - j 5.0$
• = 1025 MHz	$3.5 + j 6.0$	$5.3 - j 3.0$
M = 1090 MHz	$5.5 + j 5.5$	$3.7 - j 1.8$
• = 1150 MHz	$5.5 + j 5.0$	$3.3 - j 2.0$
H = 1215 MHz	$5.3 + j 4.5$	$3.0 - j 2.5$

TYPICAL COLLECTOR LOAD IMPEDANCE

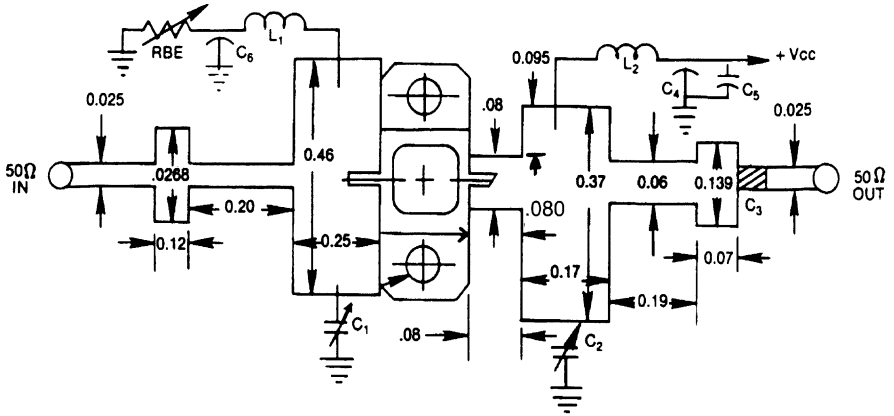


$P_{IN} = 15\text{ W}$   
 $V_{CC} = 35\text{ V}$   
 Normalized to 10 ohms



TEST CIRCUIT

Ref. Dwg. No. J-313119



All dimensions are in inches.

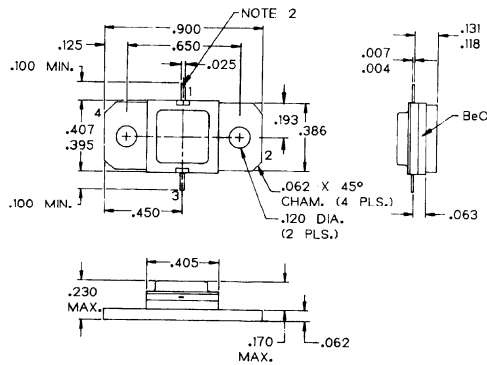
Substrate material: .025 thick  $Al_2O_3$  ( $\epsilon_r = 9.6$ )

- C1 : 0.3—3.5 pF Variable Johanson Capacitor or Equiv.
- C2 : 0.3—3.5 pF Variable Johanson Capacitor or Equiv.
- C3 : 100 pF Chip Capacitor
- C4 : 1500 pF Erie RF Feedthrough, or Equiv.

- C5 : 100 MF, Electrolytic Capacitor, 50V
- C6 : 1500 pF Erie RF Feedthrough, or Equiv.
- L1 : No. 32 Wire, 4 Turns 1/16" I.D.
- L2 : No. 32 Wire, 4 Turns 1/16" I.D.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



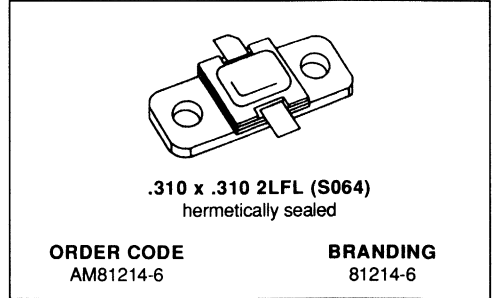
NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

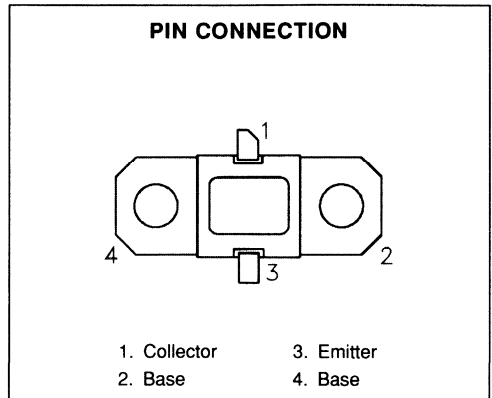
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 5.5 \text{ W MIN. WITH } 10 \text{ dB GAIN}$


**DESCRIPTION**

The AM81214-006 device is a high power Class C transistor specifically designed for L-Band Radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 5:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

AM81214-006 is supplied in the grounded IMPAC™ Hermetic Metal/Ceramic package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}\text{C}$ )	16.7	W
$I_C$	Device Current*	0.82	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	9.0	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	48	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 5mA	R <sub>BE</sub> = 10Ω	48	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 28V	—	—	1.0	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5 V	I <sub>C</sub> = 500mA	30	—	300	—

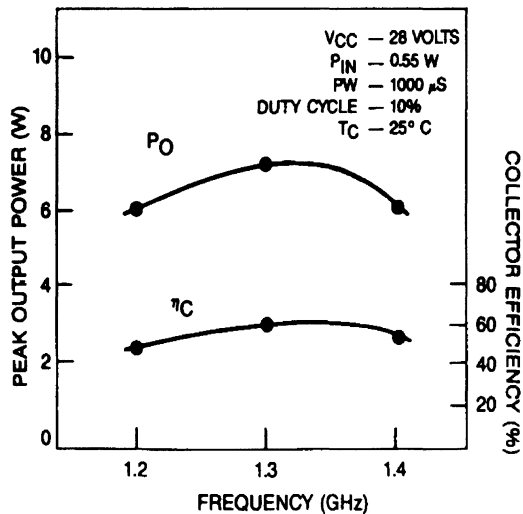
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>IN</sub>	f = 1.2 — 1.4GHz	P <sub>IN</sub> = 0.55W	V <sub>CC</sub> = 28V	—	5.5	6.2	W
η <sub>C</sub>	f = 1.2 — 1.4GHz	P <sub>IN</sub> = 0.55W	V <sub>CC</sub> = 28V	47	52	—	%
G <sub>P</sub>	f = 1.2 — 1.4GHz	P <sub>IN</sub> = 0.55W	V <sub>CC</sub> = 28V	10	10.5	—	dB

Note: Pulse Width = 1000μS  
 Duty Cycle = 10%

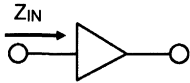
TYPICAL PERFORMANCE

TYPICAL BROADBAND PERFORMANCE

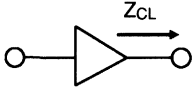


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

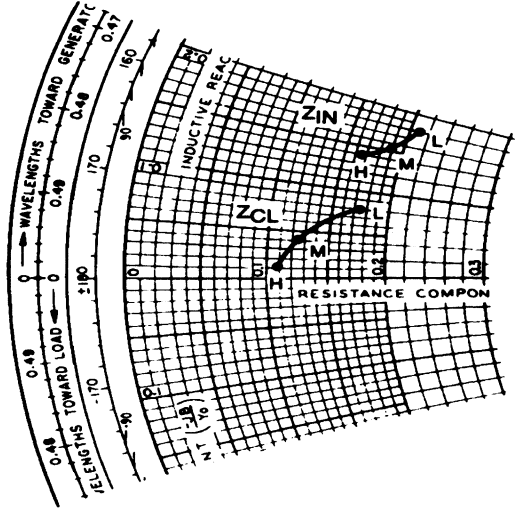


TYPICAL COLLECTOR LOAD IMPEDANCE

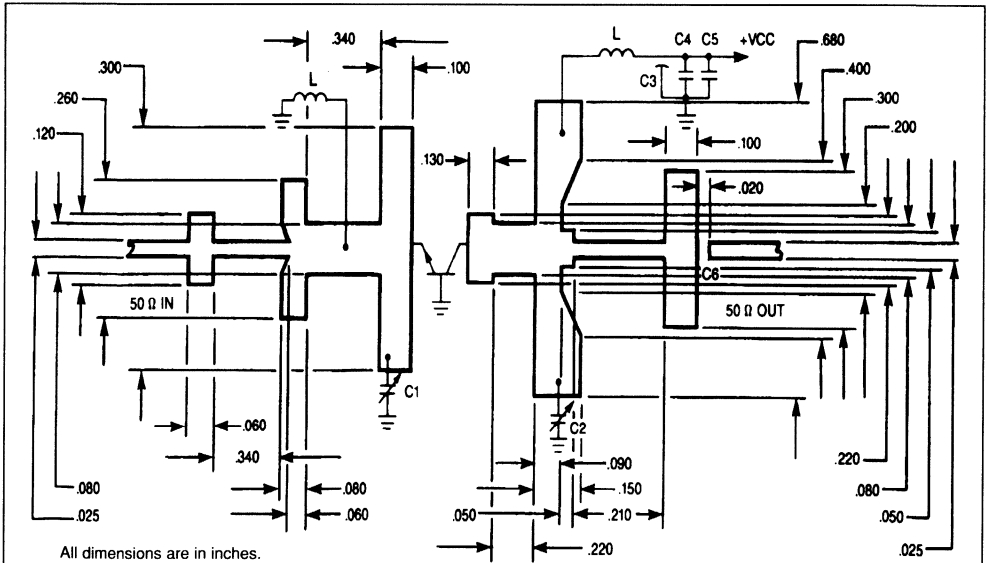


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1.2 GHz	10.5 + j 9.0	9.0 + j 3.0
M = 1.3 GHz	9.5 + j 8.0	6.5 + j 2.0
H = 1.4 GHz	8.5 + j 7.0	6.0 + j 1.0

P<sub>IN</sub> = 0.55 W  
 V<sub>CC</sub> = 28 V  
 Normalized to 50 ohms



TEST CIRCUIT

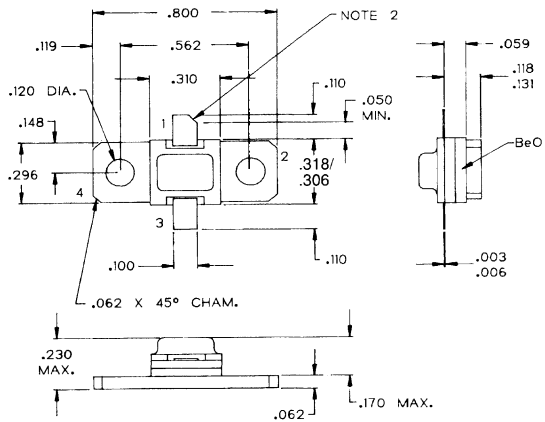


All dimensions are in inches.  
 Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub>

- C1 : 0.2–2.5 pF Johanson Gigatrim Capacitor
- C2 : 0.2–2.5 pF Johanson Gigatrim Capacitor
- C3 : 1500 pF Filtercon Feedthrough
- C4 : 0.1 μF, Ceramic Capacitor
- C5 : 100 μF, Electrolytic Capacitor
- C6 : 100 pF Chip Capacitor
- L : No. 26 Wire, 4 Turn .062 I.D.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133100D

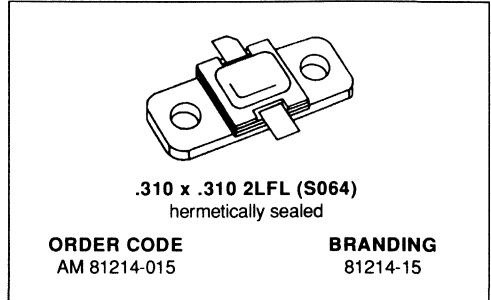


NOTES:

1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

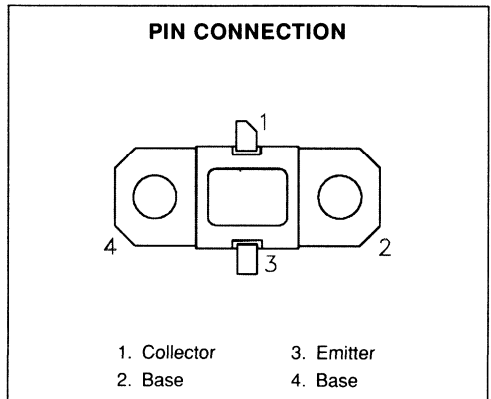
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 14.5$  W MIN. WITH 8.6 dB GAIN


**DESCRIPTION**

The AM81214-015 device is a high power Class C transistor specifically designed for L-Band Radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding 5:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

AM81214-015 is supplied in the grounded IMPACT™ Hermetic Metal/Ceramic package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	37.5	W
$I_C$	Device Current*	1.8	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	4.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 15mA$	$I_E = 0mA$	48	—	—	V
$BV_{EBO}$	$I_E = 1.5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 15mA$	$R_{BE} = 10\Omega$	48	—	—	V
$I_{CES}$	$V_{CE} = 28V$	$V_{BE} = 28V$	—	—	1.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	30	—	300	—

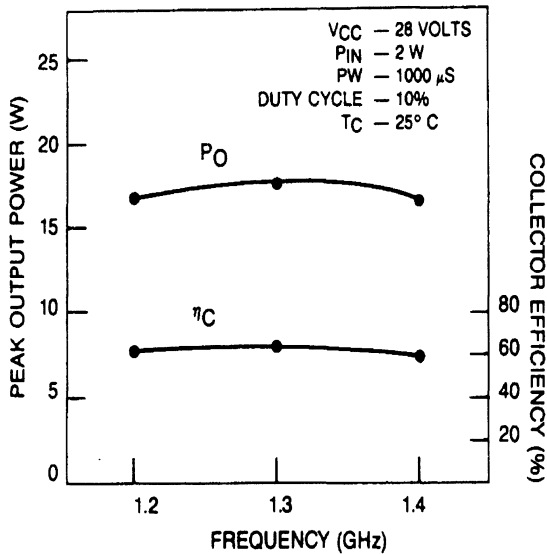
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{IN}$	$f = 1.2 - 1.4GHz$	$P_{IN} = 2W$ Peak	$V_{CC} = 28V$	14.5	17.0	—	W
$\eta_C$	$f = 1.2 - 1.4GHz$	$P_{IN} = 2W$ Peak	$V_{CC} = 28V$	48	58	—	%
$G_P$	$f = 1.2 - 1.4GHz$	$P_{IN} = 2W$ Peak	$V_{CC} = 28V$	8.6	9.3	—	dB

Note: Pulse Width = 1000  $\mu$ S  
 Duty Cycle = 10%

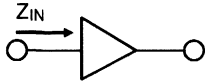
**TYPICAL PERFORMANCE**

**TYPICAL BROADBAND PERFORMANCE**

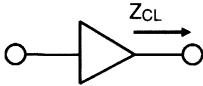


IMPEDANCE DATA

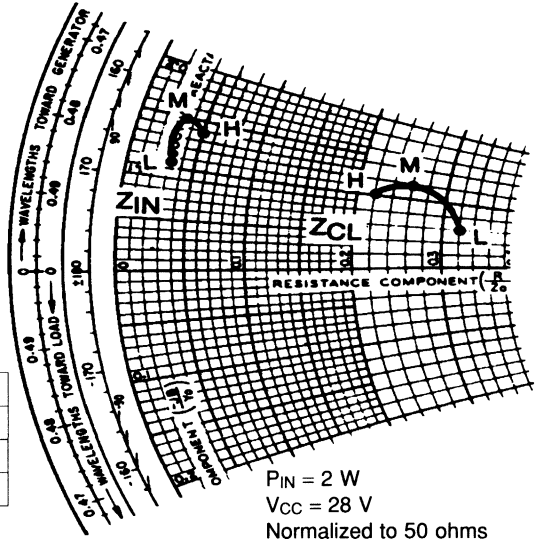
TYPICAL INPUT IMPEDANCE



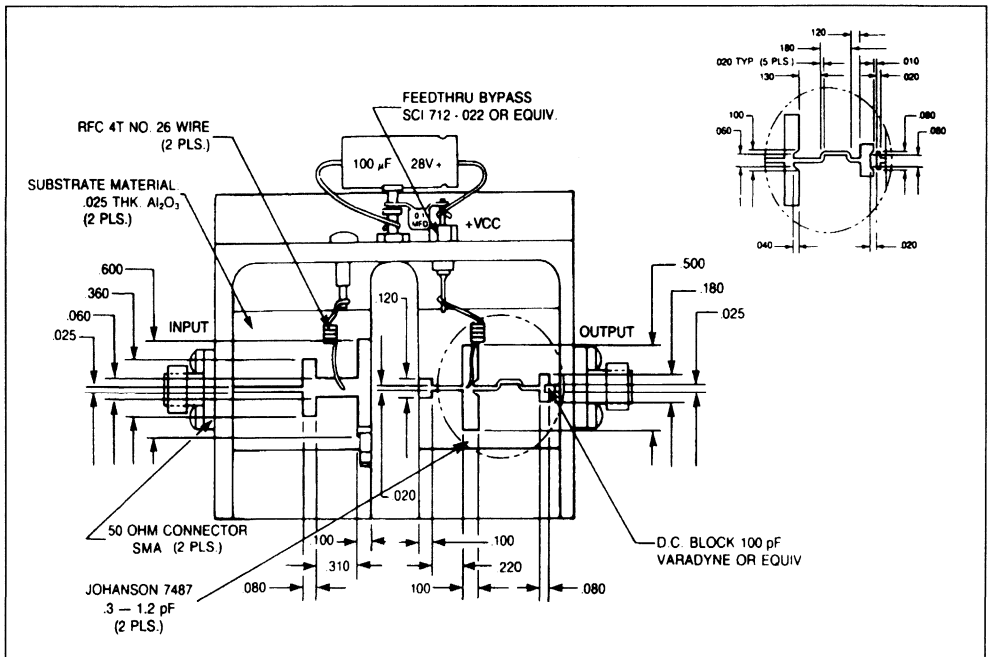
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1.2 GHz	3.0 + j 6.5	16 + j 3.0
M = 1.3 GHz	3.5 + j 7.5	13 + j 6.0
H = 1.4 GHz	5.0 + j 7.0	11 + j 5.0

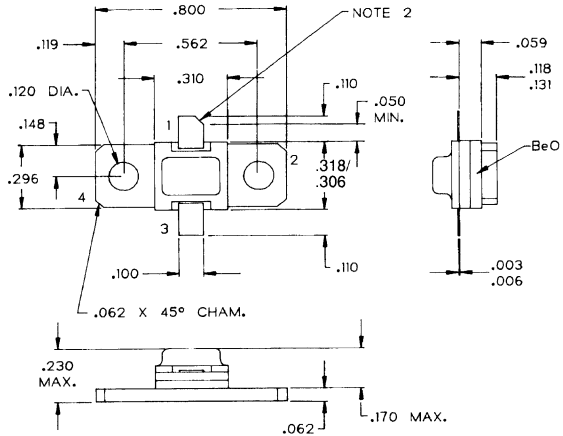


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133100D



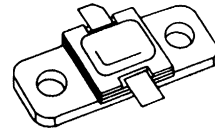
NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- RUGGEDIZED VSWR  $\infty:1$
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 26$  W MIN. WITH 7.2 dB GAIN



**.310 x .310 2LFL (S064)**  
hermetically sealed

**ORDER CODE**  
AM81214-030

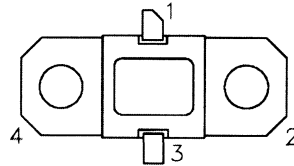
**BRANDING**  
81214-30

**DESCRIPTION**

The AM81214-030 device is a high power transistor specifically designed for L-Band Radar pulsed driver applications.

The device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding  $\infty:1$  output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM81214-030 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	63	W
$I_c$	Device Current*	2.75	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.4	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 20mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 28V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	150	—

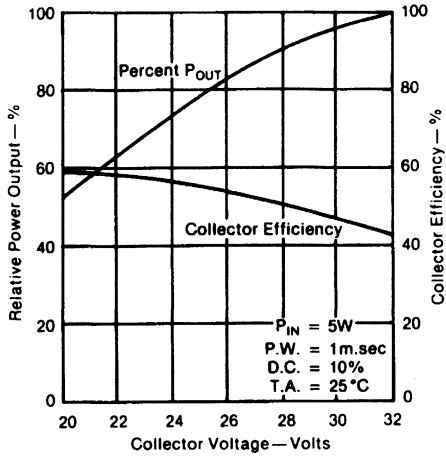
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{IN}$	$f = 1215 \text{ — } 1400MHz$	$P_{IN} = 5W \text{ Peak}$	$V_{CC} = 28V$	26	36	—	W
$\eta_C$	$f = 1215 \text{ — } 1400MHz$	$P_{IN} = 5W \text{ Peak}$	$V_{CC} = 28V$	45	49	—	%
$G_P$	$f = 1215 \text{ — } 1400MHz$	$P_{IN} = 5W \text{ Peak}$	$V_{CC} = 28V$	7.2	8.5	—	dB

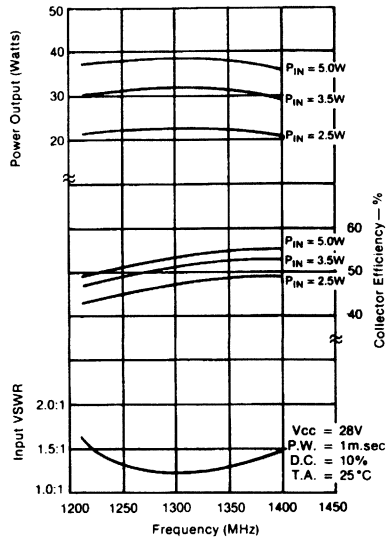
Note: Pulse Width = 1000 $\mu$ S  
 Duty Cycle = 10%

TYPICAL PERFORMANCE

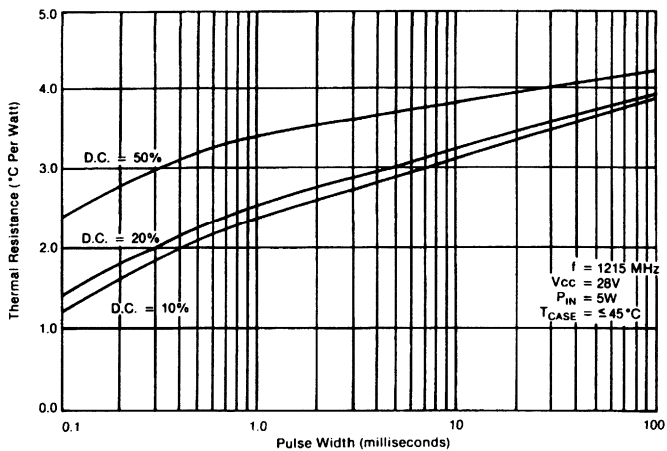
**RELATIVE POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE**



**TYPICAL BROADBAND POWER AMPLIFIER**

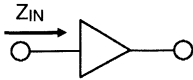


**MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH**

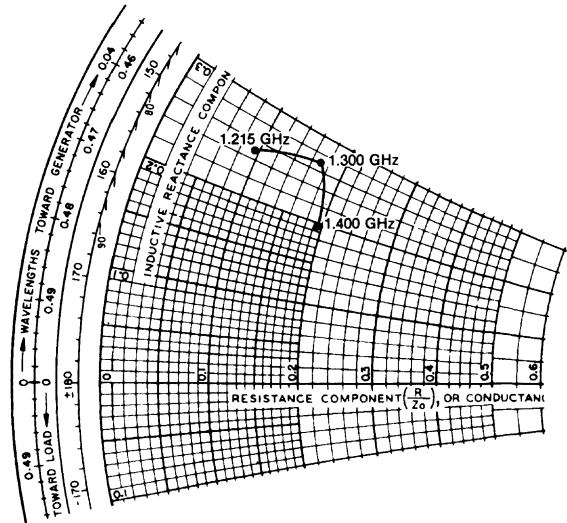


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

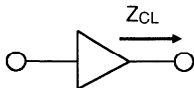


$P_{IN} = 5.0 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 $Z_0 = 50 \text{ Ohms}$

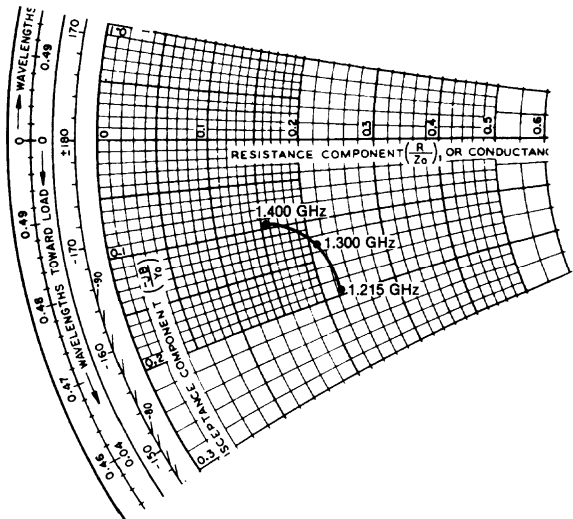


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1.215 GHz	$4.5 + j 12.5$	$11.0 - j 10.0$
M = 1.300 GHz	$8.5 + j 13.5$	$10.5 - j 6.5$
H = 1.400 GHz	$9.5 + j 10.0$	$8.0 - j 5.0$

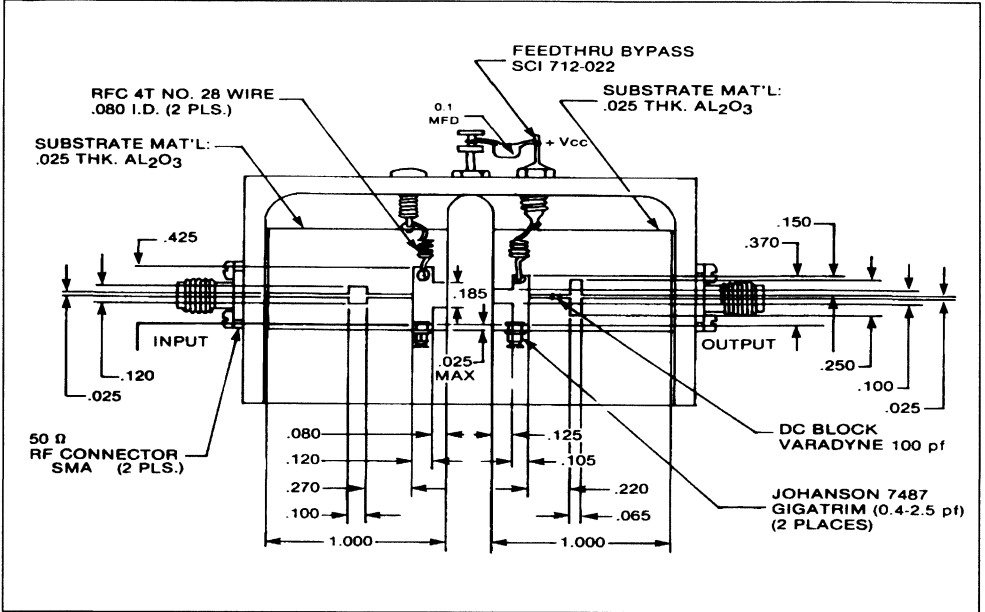
TYPICAL COLLECTOR LOAD IMPEDANCE



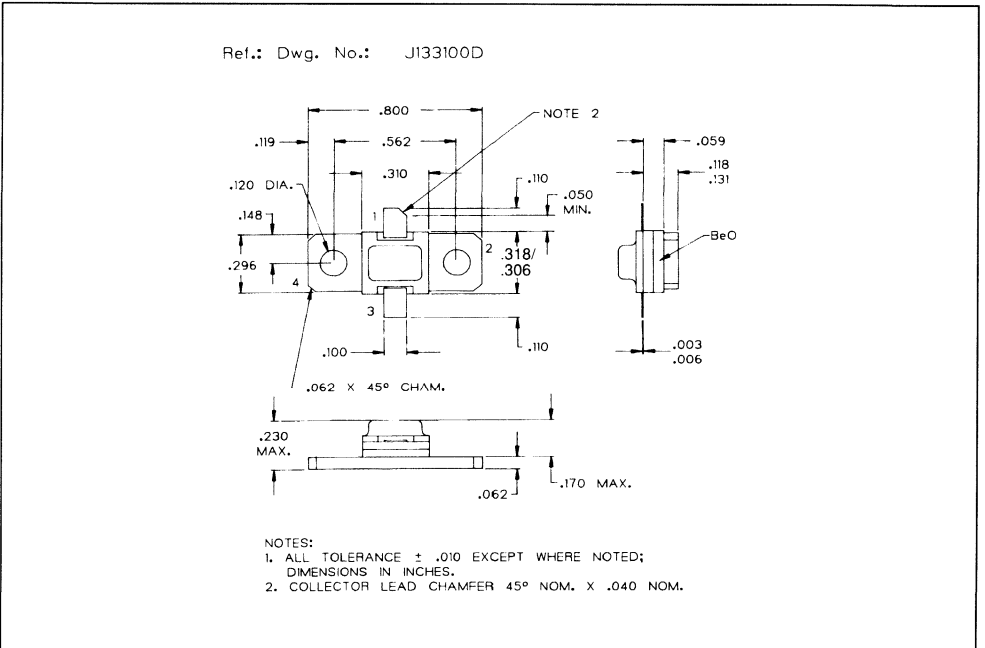
$P_{IN} = 5.0 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 $Z_0 = 50 \text{ Ohms}$



TEST CIRCUIT



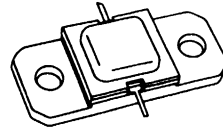
PACKAGE MECHANICAL DATA





**RF & MICROWAVE TRANSISTORS  
 L-BAND RADAR APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- RUGGEDIZED VSWR  $\infty:1$
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 55$  W MIN. WITH 6.6 dB GAIN



**.400 x .400 2NLF1 (S042)**  
hermetically sealed

**ORDER CODE**  
AM81214-060

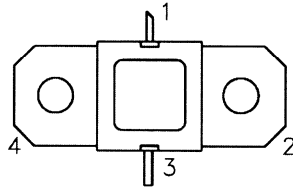
**BRANDING**  
81214-60

**DESCRIPTION**

The AM81214-060 device is a high power transistor specifically designed for L-Band radar pulsed output and driver applications.

The device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and is capable of withstanding  $\infty:1$  output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM81214-060 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	107	W
$I_C$	Device Current*	5.0	A
$V_{CC}$	Collector-Supply Voltage*	32	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.4	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 20mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 40mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 28V$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	15	—	150	—

**DYNAMIC**

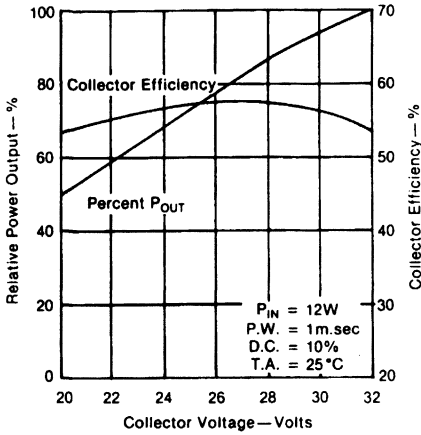
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1215 - 1400MHz$	$P_{IN} = 12W$	$V_{CC} = 28V$	55	63	—	W
$\eta_C$	$f = 1215 - 1400MHz$	$P_{IN} = 12W$	$V_{CC} = 28V$	50	57	—	%
$G_P$	$f = 1215 - 1400MHz$	$P_{IN} = 12W$	$V_{CC} = 28V$	6.6	7.2	—	dB

Note: Pulse Width = 1000 $\mu$ S  
 Duty Cycle = 10%

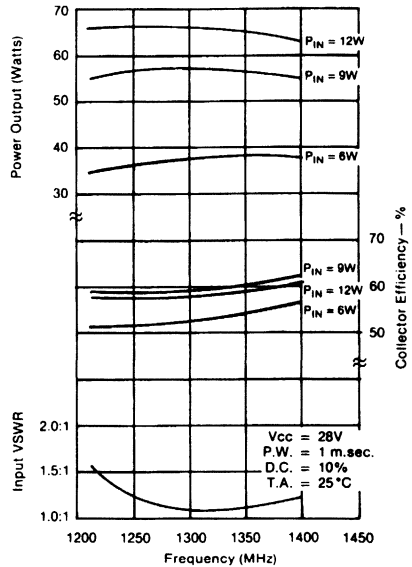


TYPICAL PERFORMANCE

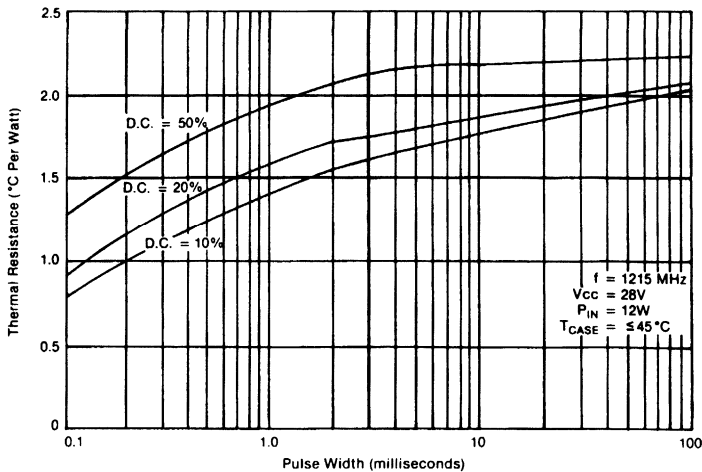
RELATIVE POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE



TYPICAL BROADBAND POWER AMPLIFIER

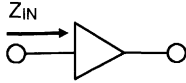


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH

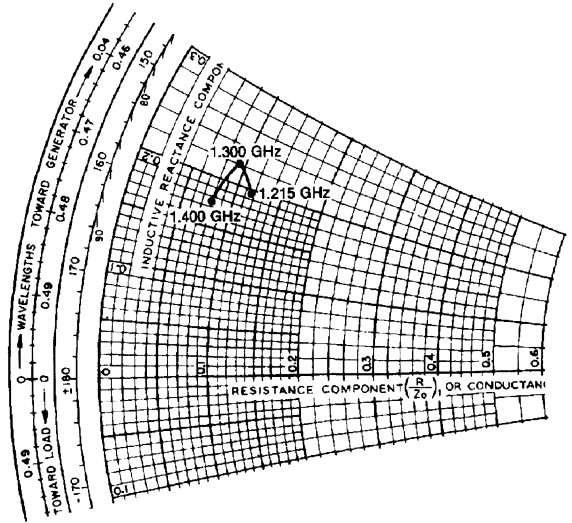


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

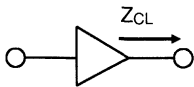


$P_{IN} = 12.0 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 $Z_0 = 50 \text{ ohms}$

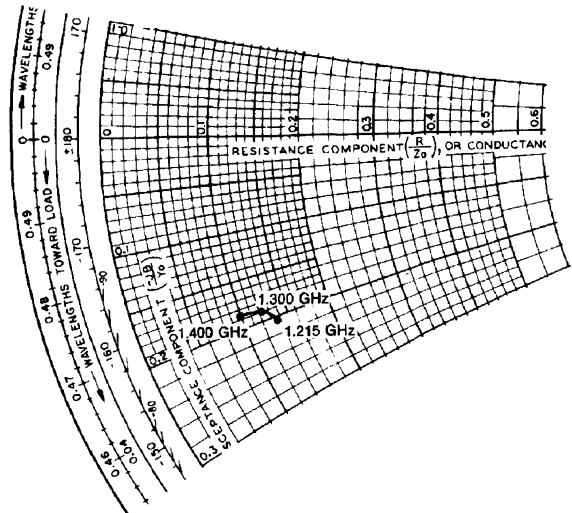


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1.2 GHz	$6.0 + j 10.0$	$7.0 - j 10.0$
M = 1.3 GHz	$4.5 + j 11.0$	$6.0 - j 9.5$
H = 1.4 GHz	$4.0 + j 9.0$	$5.0 - j 9.0$

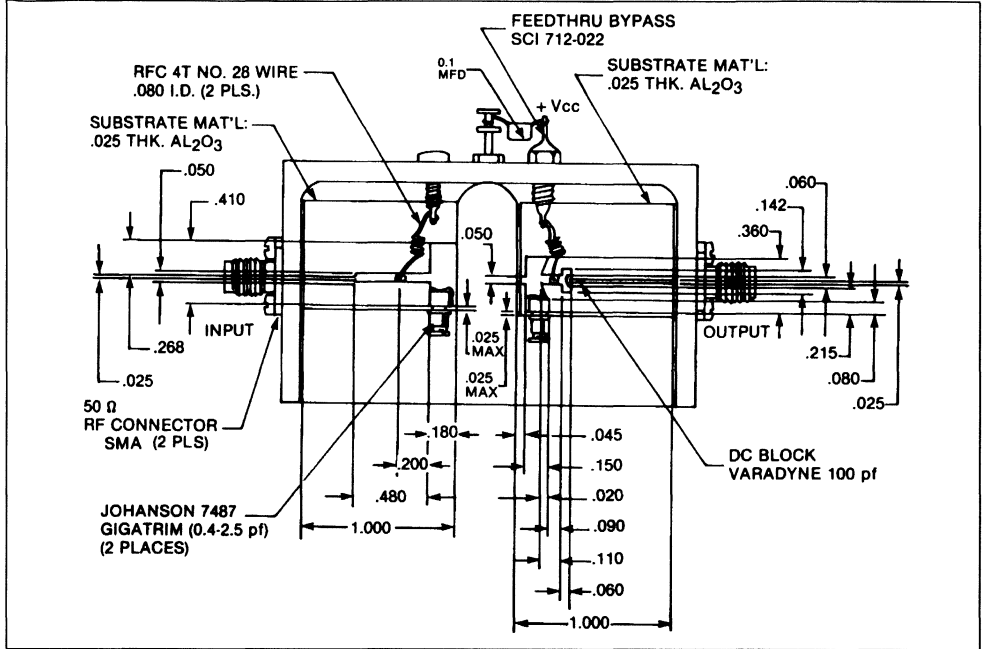
TYPICAL COLLECTOR LOAD IMPEDANCE



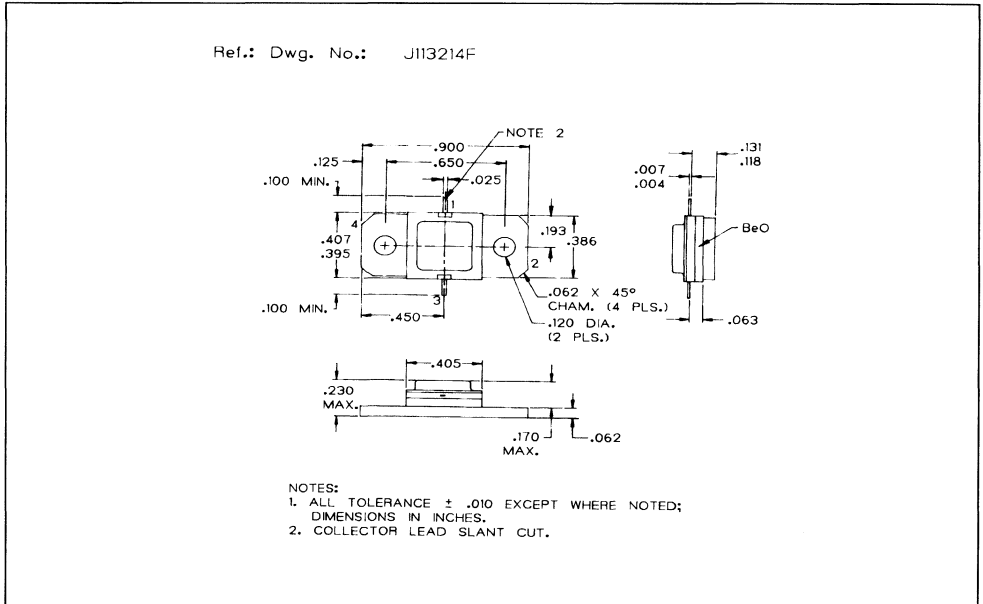
$P_{IN} = 12.0 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 $Z_0 = 50 \text{ ohms}$



TEST CIRCUIT



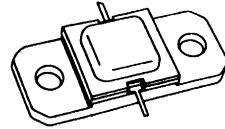
PACKAGE MECHANICAL DATA





**RF & MICROWAVE TRANSISTORS  
 TELECOMMUNICATIONS APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 5 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$



**.400 x .400 2N1FL (S042)**  
hermetically sealed

**ORDER CODE**  
AM81416-006

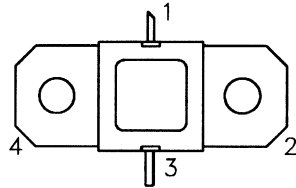
**BRANDING**  
81416-6

**DESCRIPTION**

The AM81416-006 is a common base, silicon NPN bipolar device optimized for Class C, CW operation in the 1400 - 1600 MHz frequency range.

AM81416-006 utilizes a rugged, emitter-ballasted die geometry to achieve high gain and efficiency and is suitable for driver or output stages in Class C power amplifiers.

The AM81416-006 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}\text{C}$ )	16.5	W
$I_C$	Device Current*	0.8	A
$V_{CC}$	Collector-Supply Voltage*	22	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	9.0	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

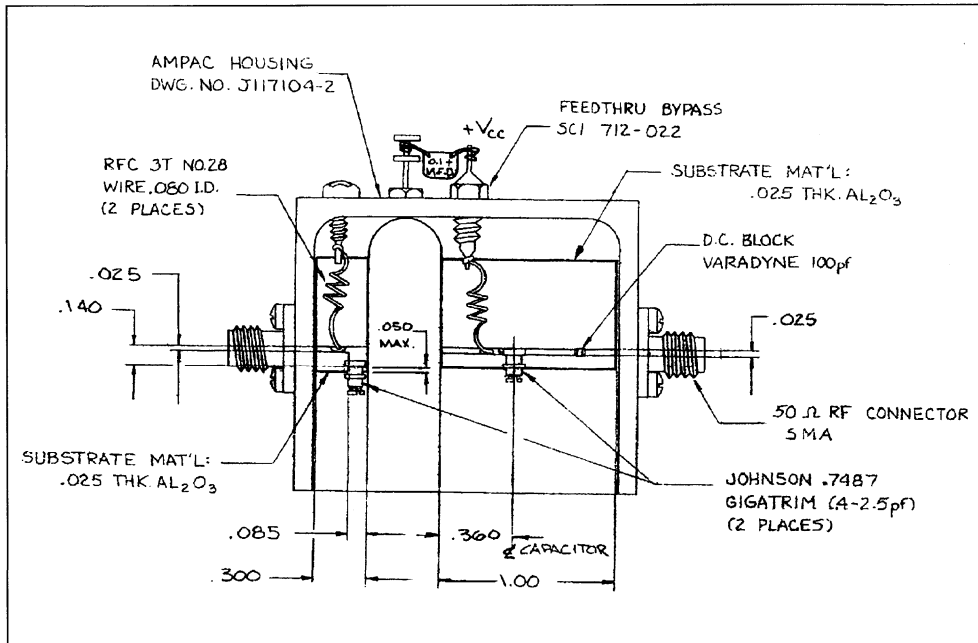
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{BE} = 0V$	$V_{CB} = 20V$	—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	20	—	300	—

DYNAMIC

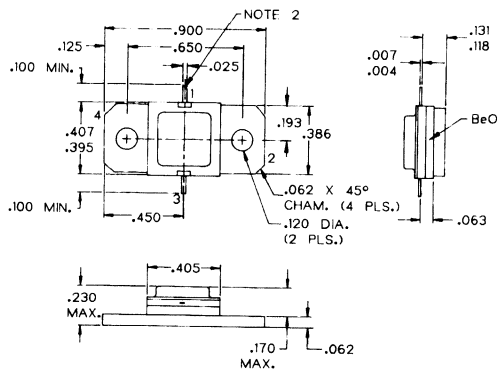
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1400 - 1600MHz$	$P_{IN} = 1.0W$	$V_{CC} = 20V$	5.0	—	—	W
$\eta_c$	$f = 1400 - 1600MHz$	$P_{IN} = 1.0W$	$V_{CC} = 20V$	50	—	—	%
$G_P$	$f = 1400 - 1600MHz$	$P_{IN} = 1.0W$	$V_{CC} = 20V$	7.0	—	—	dB

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

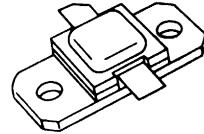
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.





**RF & MICROWAVE TRANSISTORS  
 TELECOMMUNICATIONS APPLICATIONS**

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 11.2$  W MIN. WITH 7.5 dB GAIN



**.400 x .400 2LFL (S036)**  
hermetically sealed

**ORDER CODE**  
AM81416-012

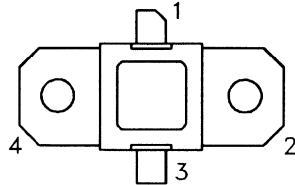
**BRANDING**  
81416-12

**DESCRIPTION**

The AM81416-012 is a common base, silicon NPN bipolar device optimized for Class C, CW operation in the 1400 - 1600 MHz frequency range.

AM81416-006 utilizes a rugged, emitter-ballasted die geometry to achieve high gain and efficiency and is suitable for driver or output stages in Class C power amplifiers.

The AM81416-006 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	27	W
$I_c$	Device Current*	1.5	A
$V_{CC}$	Collector-Supply Voltage*	22	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	5.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

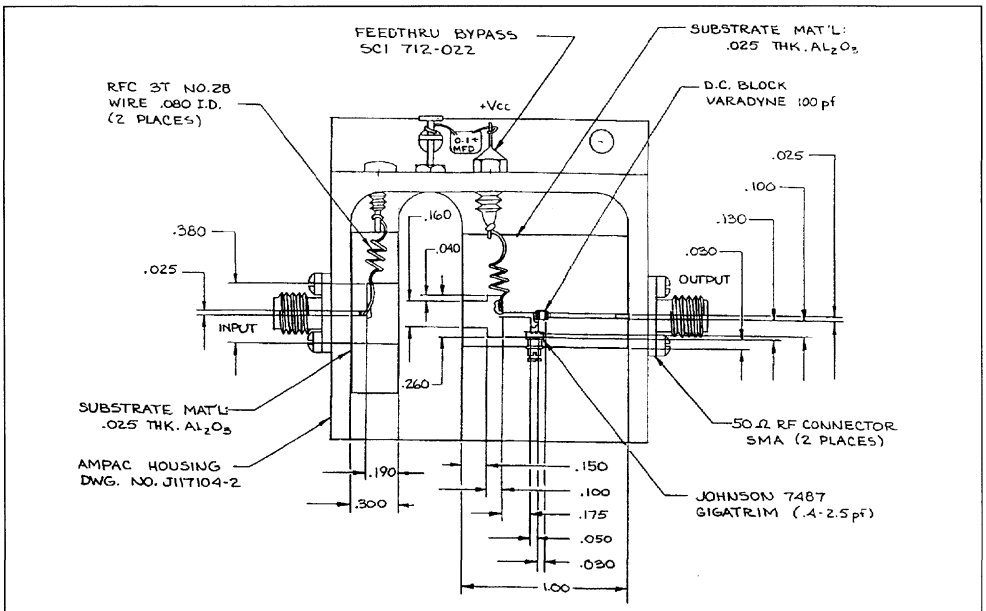
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	40	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CBO</sub>	V <sub>BE</sub> = 0V	V <sub>CB</sub> = 20V	—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	20	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1400 — 1600MHz	P <sub>IN</sub> = 2.0W	V <sub>CC</sub> = 20V	11.2	—	—	W
η <sub>c</sub>	f = 1400 — 1600MHz	P <sub>IN</sub> = 2.0W	V <sub>CC</sub> = 20V	47	—	—	%
GP	f = 1400 — 1600MHz	P <sub>IN</sub> = 2.0W	V <sub>CC</sub> = 20V	7.5	—	—	dB

TEST CIRCUIT

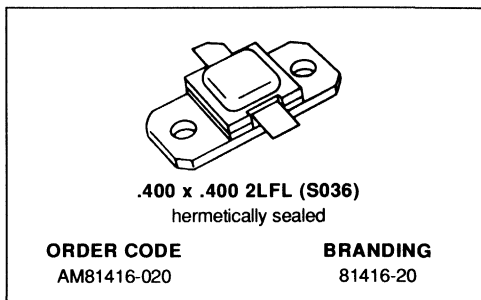






**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

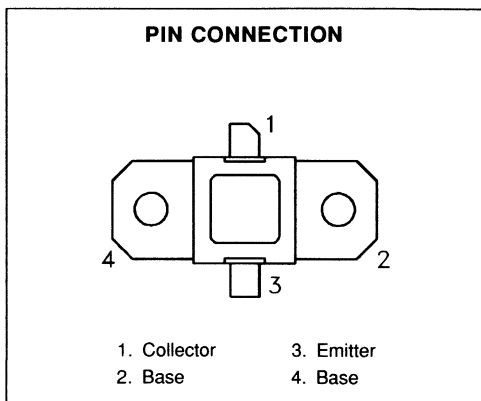
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 17.6$  W MIN. WITH 6.4 dB GAIN


**DESCRIPTION**

The AM81416-020 is a common base, silicon NPN bipolar device optimized for Class C, CW operation in the 1400 - 1600 MHz frequency range.

AM81416-020 utilizes a rugged, emitter-ballasted die geometry to achieve high gain and efficiency and is suitable for driver or output stages in Class C power amplifiers.

The AM81416-020 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic pack-


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	50	W
$I_C$	Device Current*	2.8	A
$V_{CC}$	Collector-Supply Voltage*	22	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	3.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

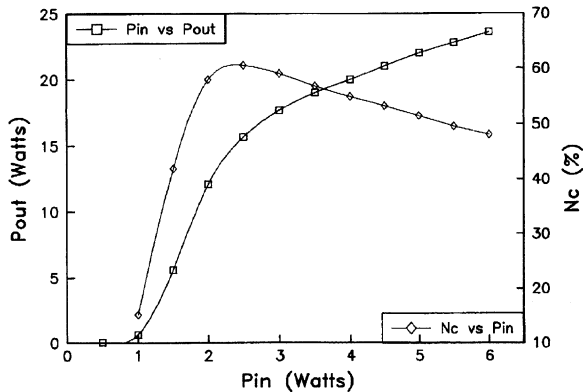
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.0	—	—	V
$I_{CBO}$	$V_{CB} = 20V$		—	—	2.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	15	—	150	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1400 - 1600MHz$	$P_{IN} = 4.0W$	$V_{CC} = 20V$	17.6	—	—	W
$\eta_C$	$f = 1400 - 1600MHz$	$P_{IN} = 4.0W$	$V_{CC} = 20V$	45	—	—	%
GP	$f = 1400 - 1600MHz$	$P_{IN} = 4.0W$	$V_{CC} = 20V$	6.4	—	—	dB

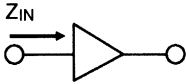
TYPICAL PERFORMANCE

**POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**

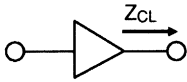


**IMPEDANCE DATA**

**TYPICAL INPUT IMPEDANCE**

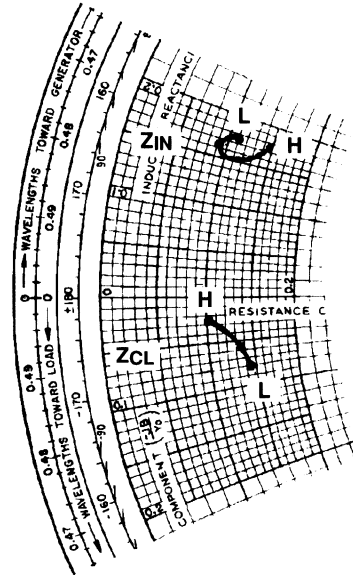


**TYPICAL COLLECTOR LOAD IMPEDANCE**

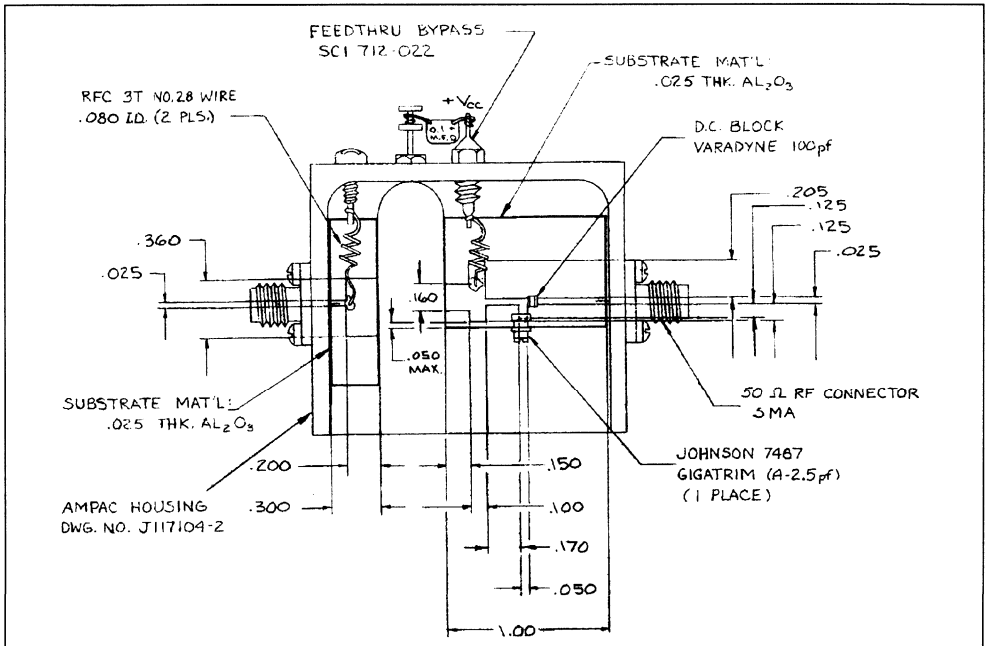


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1.4 GHz	5.5 + j 8.8	7.0 - j 4.0
M = 1.5 GHz	4.6 + j 8.3	6.8 - j 2.8
H = 1.6 GHz	7.4 + j 8.9	5.1 - j 1.3

P<sub>IN</sub> = 4.0W  
 V<sub>CC</sub> = 20V  
 Normalized to 50 ohms

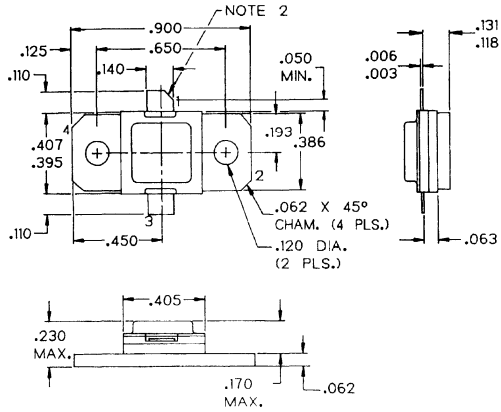


**TEST CIRCUIT**



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



NOTES:

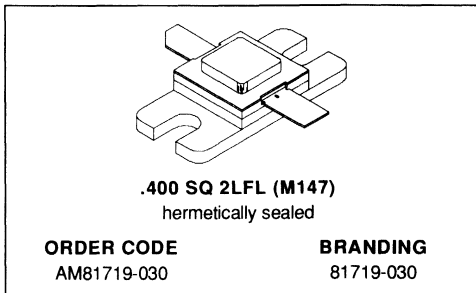
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 TELEMETRY APPLICATIONS**

PRELIMINARY DATA

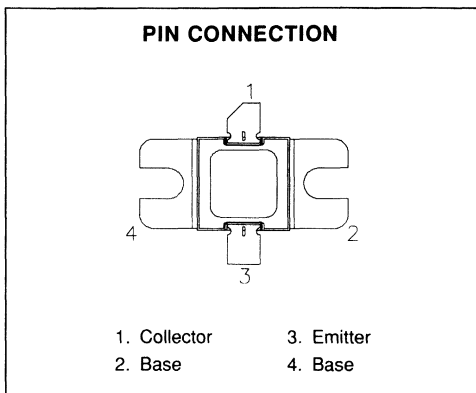
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 28$  W MIN. WITH 6.7 dB GAIN


**DESCRIPTION**

The AM81719-030 is a high power silicon NPN bipolar transistor designed for Class C, CW communications and telemetry applications in the 1.75 - 1.85 GHz frequency range.

An emitter site ballasted refractory/gold overlay die geometry computerized automatic wire bonding is employed to ensure long term reliability and product consistency.

AM81719-030 is supplied in the industry-standard AMPAC™ hermetic metal/ceramic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	67.3	W
$I_C$	Device Current*	2.67	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.6	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** (T<sub>case</sub> = 25°C)

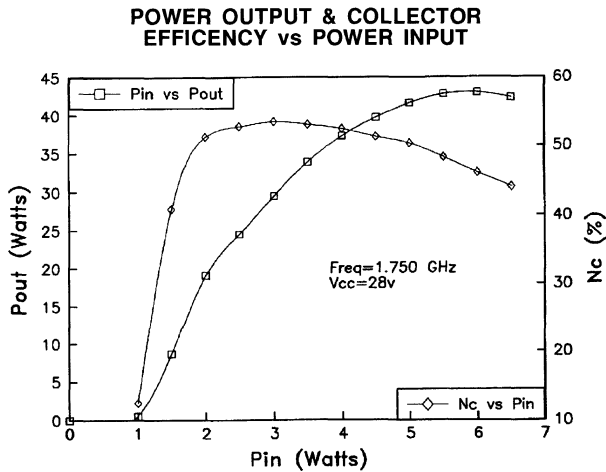
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 10mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	3.0	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 10mA		45	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 28V	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 2mA	15	—	150	—

**DYNAMIC**

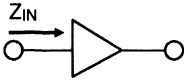
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1.75 — 1.85GHz	P <sub>IN</sub> = 6.0W	V <sub>CC</sub> = 28V	28	—	—	W
η <sub>c</sub>	f = 1.75 — 1.85GHz	P <sub>IN</sub> = 6.0W	V <sub>CC</sub> = 28V	40	—	—	%
G <sub>P</sub>	f = 1.75 — 1.85GHz	P <sub>IN</sub> = 6.0W	V <sub>CC</sub> = 28V	6.7	—	—	dB

**TYPICAL PERFORMANCE**

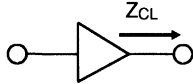


IMPEDANCE DATA

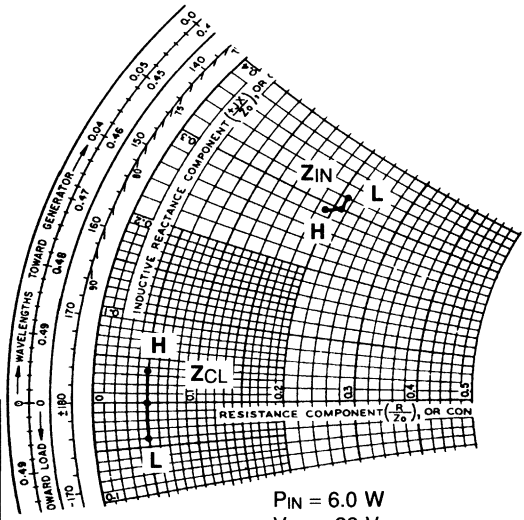
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



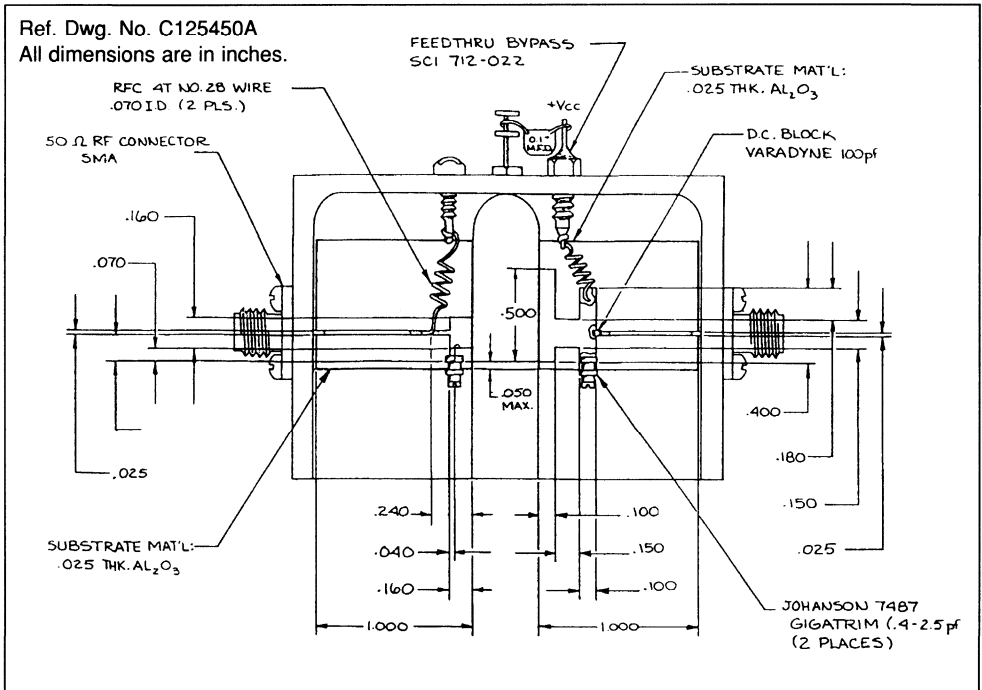
FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1.7 GHz	10.5 + j 16.0	2.5 - j 2.0
M = 1.8 GHz	10.25 + j 15.0	2.5 + j 0.0
H = 1.9 GHz	9.5 + j 14.5	2.5 + j 2.0



P<sub>IN</sub> = 6.0 W  
 V<sub>CC</sub> = 28 V  
 Normalized to 50 ohms

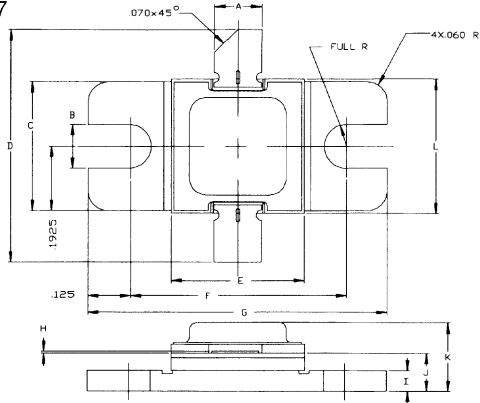
TEST CIRCUIT

Ref. Dwg. No. C125450A  
 All dimensions are in inches.



PACKAGE MECHANICAL DATA

Ref.: Dwg. No. 12-0147

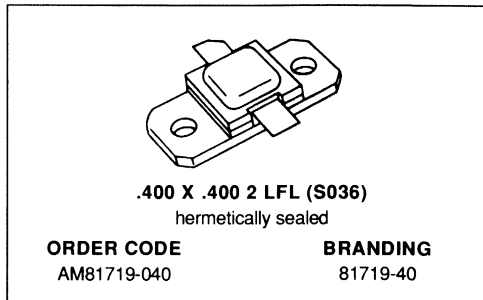


SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	135/3,43	145/3,68	K	.230/5,84
B	125/3,18		L	.392/9,96
C	.380/9,65	.390/9,91		
D	885/22,48			
E	.392/9,96	.402/10,29		
F	.645/16,38	.655/16,64		
G	.895/22,73	.905/22,99		
H	.002/0,05	.006/0,15		
I	.055/1,40	.065/1,65		
J	.105/2,67	.125/3,18		

**RF & MICROWAVE TRANSISTORS  
 TELEMETRY APPLICATIONS**

PRELIMINARY DATA

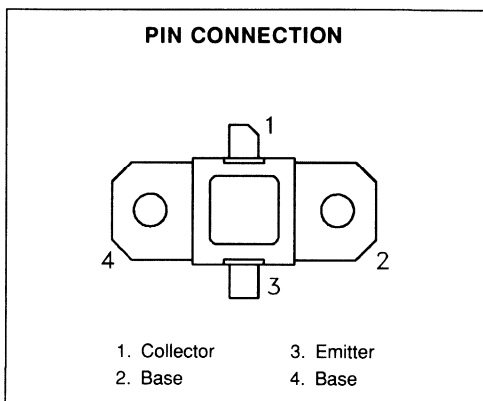
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 40$  W MIN. WITH 7 dB GAIN


**DESCRIPTION**

The AM81719-040 is a high power silicon NPN bipolar transistor designed for Class C, CW communications and telemetry applications in the 1.75 - 1.85 GHz frequency range.

An emitter-ballasted refractory-gold overlay die geometry with computerized automatic wire-bonding is employed to ensure long-term reliability and product consistency.

AM81719-040 is supplied in the industry-standard AMPAC™ hermetic metal/ceramic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	79.5	W
$I_c$	Device Current*	4.8	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.2	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

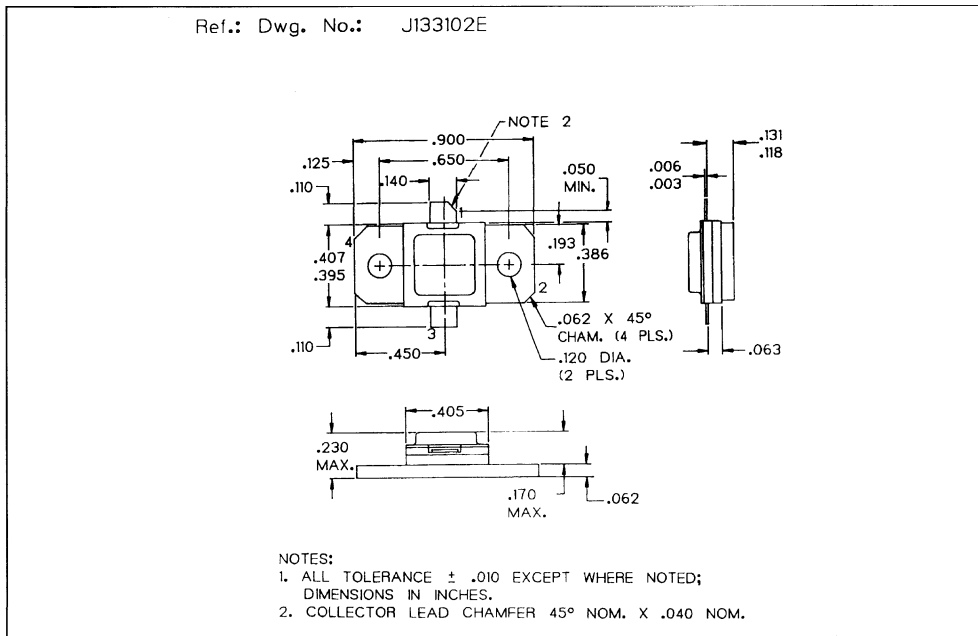
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 4mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 80mA$		45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	8	mA
$h_{FE}$	$V_{CE} = 30V$	$I_C = 2.5A$	30	—	300	—

DYNAMIC

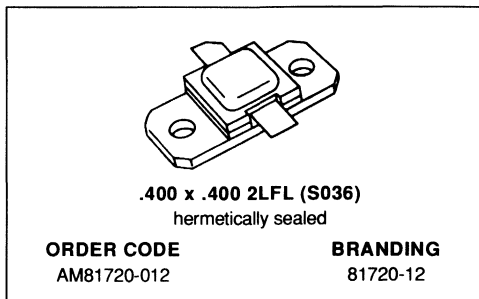
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1750 - 1850MHz$	$P_{IN} = 8.0W$	$V_{CC} = 28V$	40	—	—	W
$\eta_C$	$f = 1750 - 1850MHz$	$P_{IN} = 8.0W$	$V_{CC} = 28V$	45	—	—	%
$G_P$	$f = 1750 - 1850MHz$	$P_{IN} = 8.0W$	$V_{CC} = 28V$	6.7	—	—	dB

PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

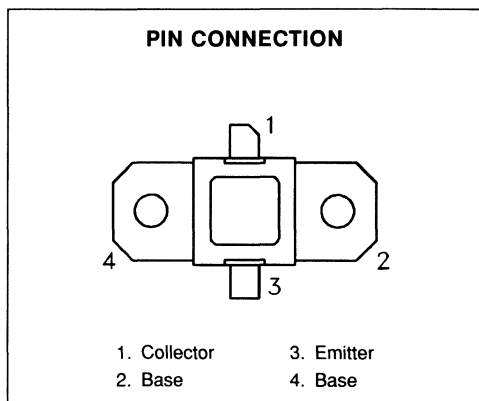
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- RUGGIZED VSWR  $\infty:1$
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 12$  W MIN. WITH 7.4 dB GAIN


**DESCRIPTION**

The AM81720-012 is designed specifically for Telecommunications applications.

The device is capable of withstanding any mismatch load condition at any phase angle (VSWR  $\infty:1$ ) under full rated conditions. The unit is an overlay, emitter site ballasted, geometry utilizing a refractory/gold metallization system.

The unique AMPAC™ devices are housed in Hermetic Metal/Ceramic packages with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	31.8	W
$I_C$	Device Current*	1.47	A
$V_{CC}$	Collector-Supply Voltage*	24	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.5	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

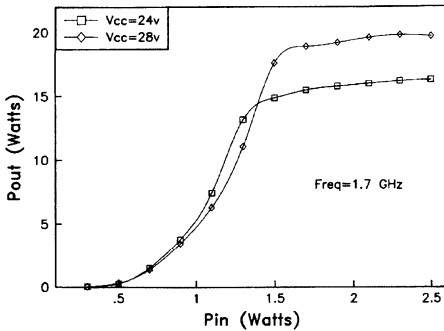
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	I <sub>C</sub> = 0mA	3.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 24V		—	—	1.25	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	15	—	150	—

DYNAMIC

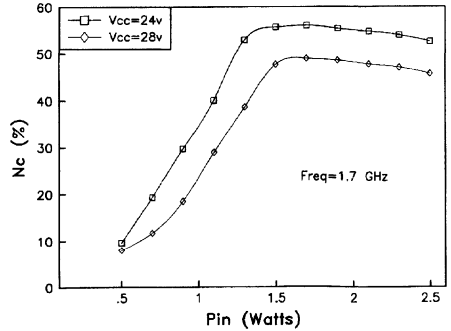
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1.7 — 2.0GHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	12	—	—	W
η <sub>C</sub>	f = 1.7 — 2.0GHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	40	—	—	%
G <sub>P</sub>	f = 1.7 — 2.0GHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	7.4	—	—	dB

TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

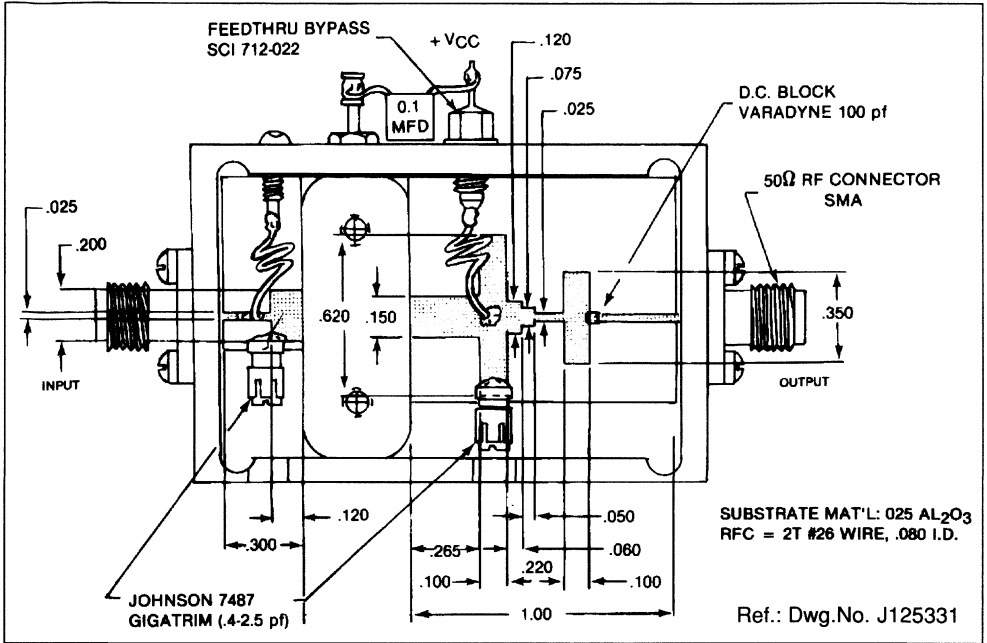


COLLECTOR EFFICIENCY vs POWER INPUT



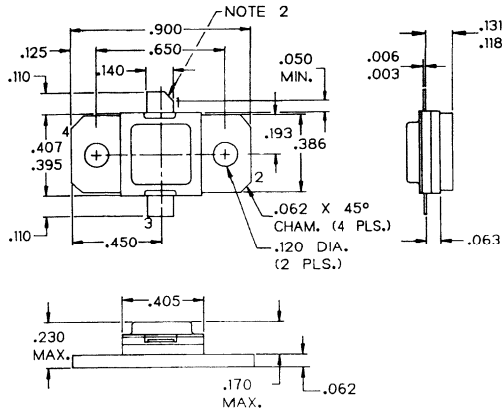


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



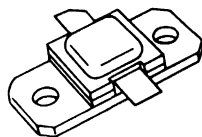
NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



## RF & MICROWAVE TRANSISTORS COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- RUGGEDIZED VSWR  $\infty:1$
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 20 W MIN. WITH 6.5 dB GAIN



**.400 x .400 2LFL (S036)**  
hermetically sealed

**ORDER CODE**  
AM81720-020

**BRANDING**  
81720-20

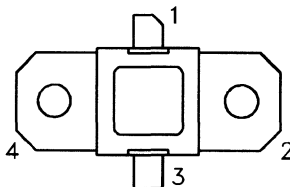
### DESCRIPTION

The AM81720-020 device is designed specifically for Telecommunications applications.

The device is capable of withstanding any mismatch load condition at any phase angle (VSWR  $\infty:1$ ) under full rated conditions. The unit is an overlay, emitter site ballasted, geometry utilizing a refractory/gold metallization system.

The unique AMPAC™ devices are housed in Hermetic Metal/Ceramic packages with internal Input/Output matching structures.

### PIN CONNECTION



- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation*	58.3	W
I <sub>C</sub>	Device Current*	3.0	A
V <sub>CC</sub>	Collector-Supply Voltage*	28	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	3.0	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

# AM81720-020

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

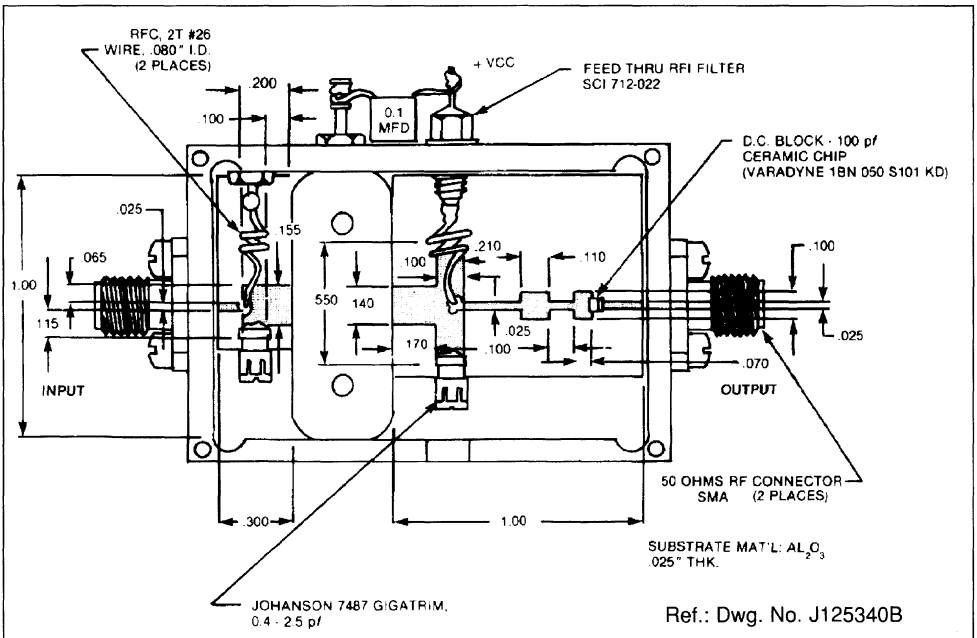
### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{CB} = 24V$		—	—	2	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	30	—	300	—

### DYNAMIC

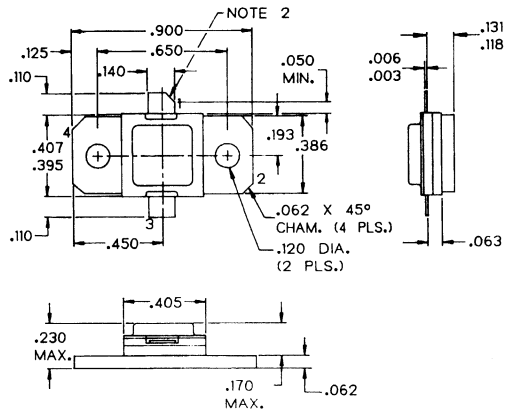
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1700 - 2000MHz$	$P_{IN} = 4.5W$	$V_{CC} = 24V$	20	—	—	W
$\eta_c$	$f = 1700 - 2000MHz$	$P_{IN} = 4.5W$	$V_{CC} = 24V$	42	—	—	%
$G_P$	$f = 1700 - 2000MHz$	$P_{IN} = 4.5W$	$V_{CC} = 24V$	6.5	—	—	dB

### TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E  
Case Style: S036



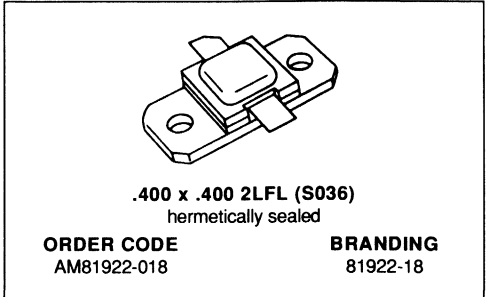
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER  $45^\circ$  NOM. X  $.040$  NOM.



**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

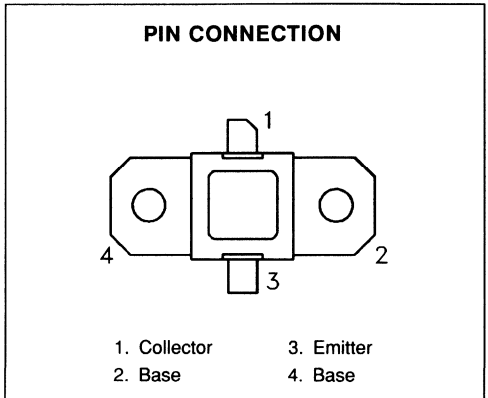
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- RUGGIZED VSWR  $\infty:1$
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 18$  W MIN. WITH 6.0 dB GAIN


**DESCRIPTION**

The AM81922-018 device is designed specifically for Telecommunications applications.

The device is capable of withstanding any mismatch load condition at any phase angle (VSWR  $\infty:1$ ) under full rated conditions. The unit is an overlay, emitter site ballasted, geometry utilizing a Refractory/gold metallization system.

The unique AMPAC™ devices are housed in Hermetic Metal/Ceramic packages with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	58.3	W
$I_c$	Device Current*	2.7	A
$V_{CC}$	Collector-Supply Voltage*	24	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	3.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

Note: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

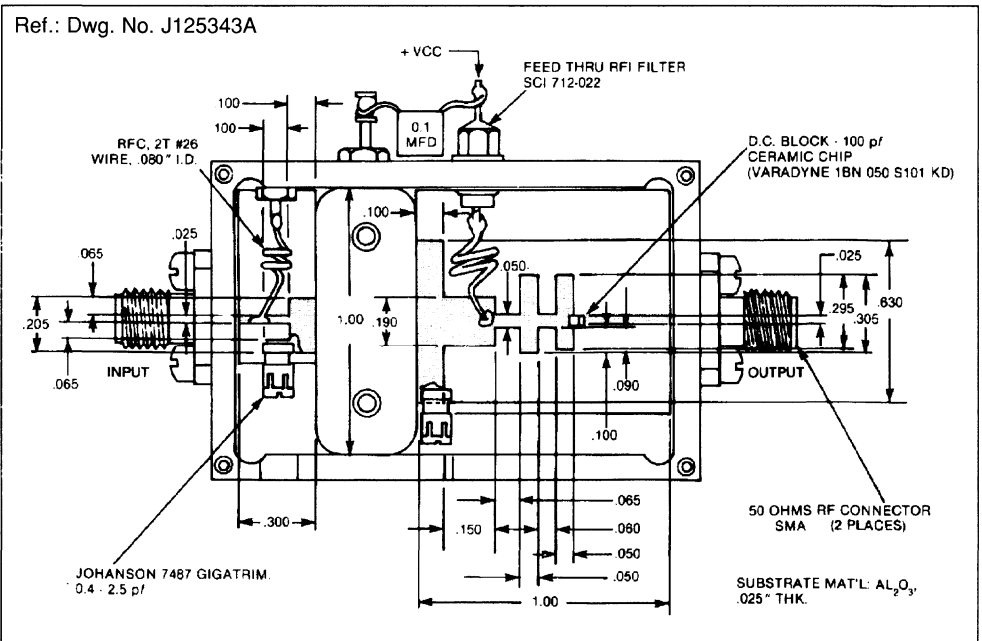
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 8mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 8mA	I <sub>C</sub> = 0mA	3.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	2	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1.6A	15	—	150	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1900 — 2200MHz	P <sub>IN</sub> = 4.5W	V <sub>CC</sub> = 24V	18	—	—	W
η <sub>C</sub>	f = 1900 — 2200MHz	P <sub>IN</sub> = 4.5W	V <sub>CC</sub> = 24V	40	—	—	%
G <sub>P</sub>	f = 1900 — 2200MHz	P <sub>IN</sub> = 4.5W	V <sub>CC</sub> = 24V	6.0	—	—	dB

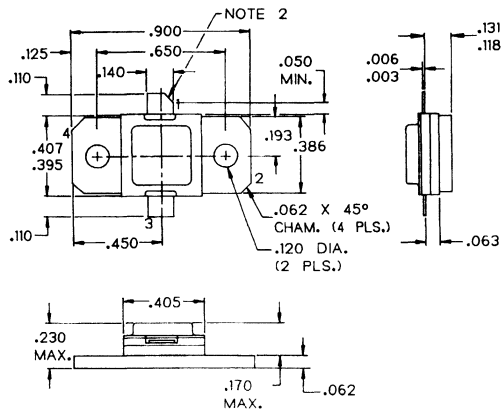
TEST CIRCUIT





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



## NOTES:

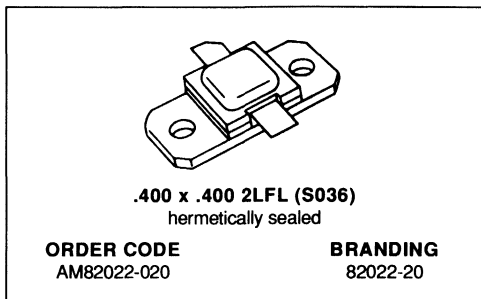
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 TELEMETRY APPLICATIONS**

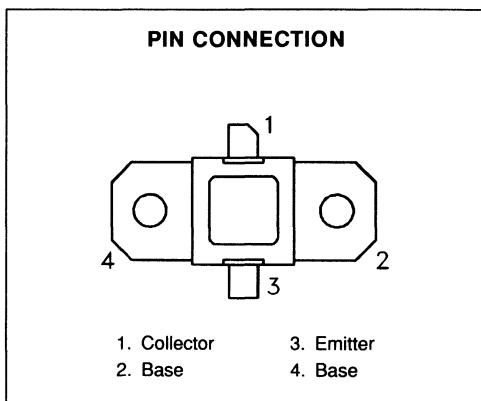
PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 20$  W MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

The AM82022-020 is a common base NPN silicon power transistor optimized for high gain and efficiency in the 2.0 - 2.2 GHz frequency range.

Ideal for Class C, CW power amplifier applications, the AM82022-020 utilizes an emitter-ballasted, gold metallized die geometry and is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	60	W
$I_C$	Device Current*	3	A
$V_{CC}$	Collector-Supply Voltage*	25	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 12mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 2.5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{BE} = 0V$	$V_{CB} = 22V$	—	—	2.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	30	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.0 - 2.2GHz$	$P_{IN} = 4.0W$	$V_{CC} = 22V$	20	—	—	W
$\eta_c$	$f = 2.0 - 2.2GHz$	$P_{IN} = 4.0W$	$V_{CC} = 22V$	40	—	—	%
$G_P$	$f = 2.0 - 2.2GHz$	$P_{IN} = 4.0W$	$V_{CC} = 22V$	7.0	—	—	dB

**PACKAGE MECHANICAL DATA**

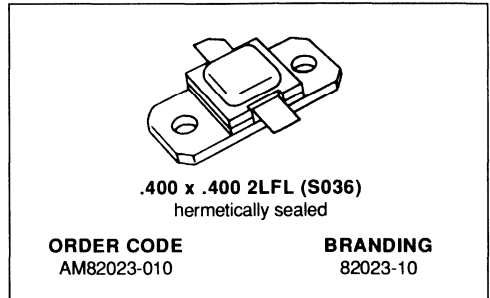
Ref.: Dwg. No.: J133102E

NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER  $45^{\circ}$  NOM. X  $.040$  NOM.

## RF & MICROWAVE TRANSISTORS COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- ∞:1 VSWR CAPABILITY AT RATED CONDITIONS
- INPUT/OUTPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 10 W MIN. WITH 6.6 dB GAIN

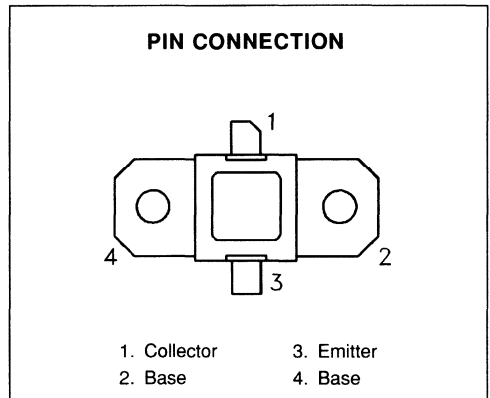


### DESCRIPTION

The AM82023-010 device is designed specifically for Telemetry and Communications applications.

The device is capable of withstanding any mismatch load condition at any phase angle (VSWR ∞:1) under full rated conditions. The unit is an overlay, emitter site ballasted, geometry utilizing a Refractory/Gold metallization system.

The unique AMPAC™ devices are housed in Hermetic Metal/Ceramic packages with internal Input/Output matching structures.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation*	31.8	W
I <sub>C</sub>	Device Current*	1.75	A
V <sub>CC</sub>	Collector-Supply Voltage*	28	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	5.5	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

Note: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

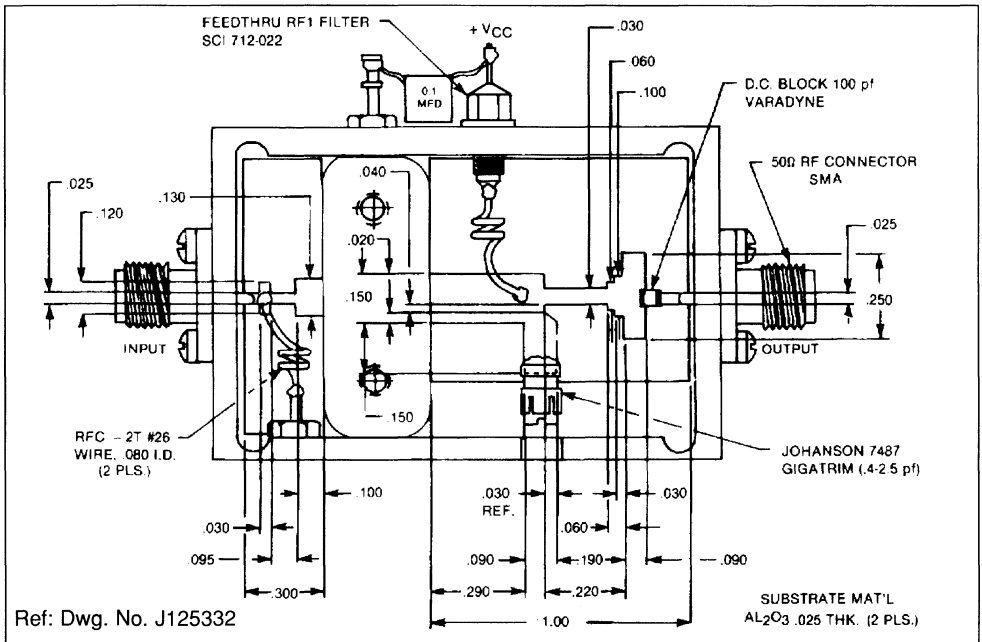
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 24V		—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	30	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2000 — 2300MHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	10	—	—	W
η <sub>c</sub>	f = 2000 — 2300MHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	40	—	—	%
G <sub>P</sub>	f = 2000 — 2300MHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	6.6	—	—	dB

TEST CIRCUIT



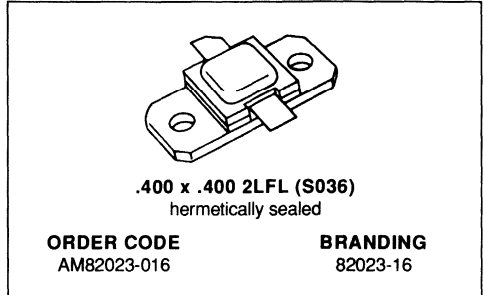






**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

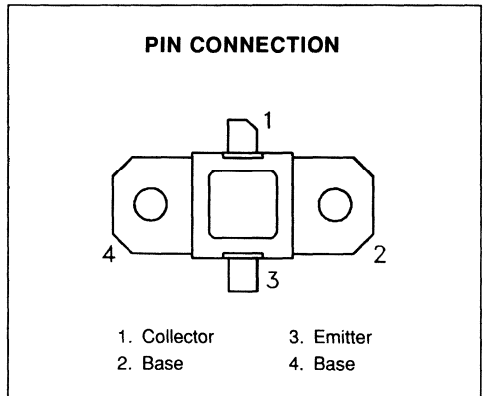
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty:1$  VSWR CAPABILITY AT RATED CONDITIONS
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 16$  W MIN. WITH 6.0 dB GAIN


**DESCRIPTION**

The AM82023-016 device is designed specifically for Telemetry and Communications applications.

The device is capable of withstanding any mismatch load condition at any phase angle (VSWR  $\infty:1$ ) under full rated conditions. The unit is an overlay, emitter site ballasted, geometry utilizing a refractory/gold metallization system.

The unique AMPAC™ devices are housed in Hermetic Metal/Ceramic packages with internal Input/Output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	58.3	W
$I_C$	Device Current*	3.0	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.0	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

Note: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

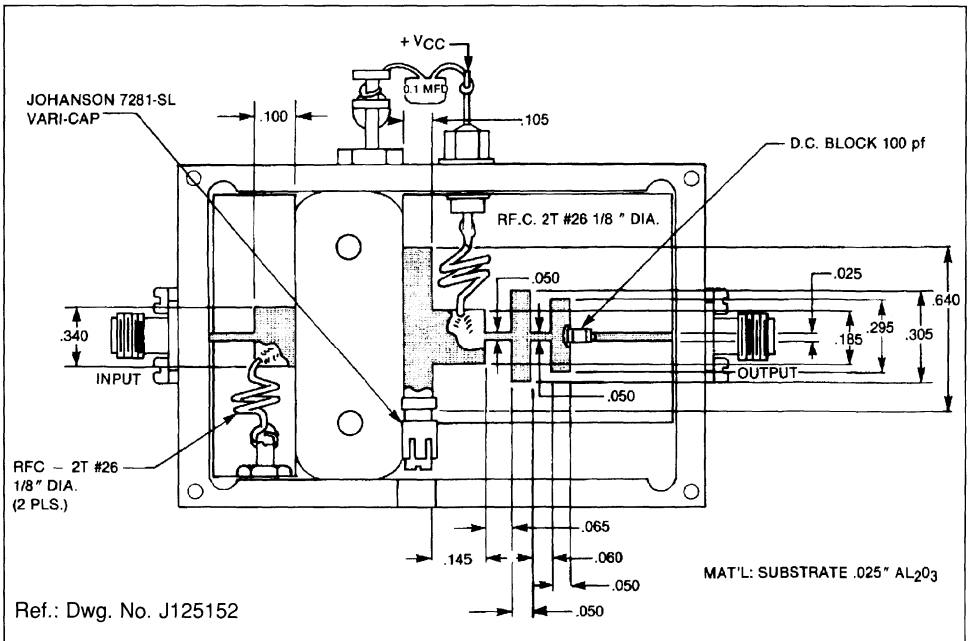
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{CB} = 24V$		—	—	2	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	30	—	300	—

DYNAMIC

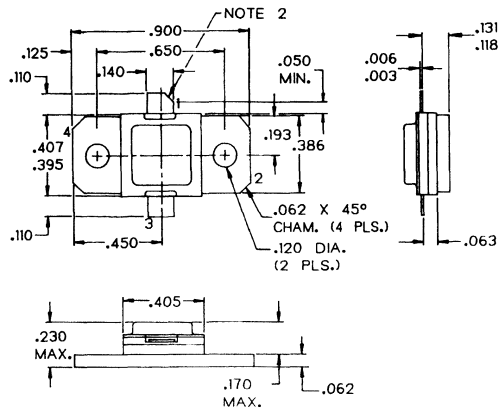
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2000 - 2300MHz$	$P_{IN} = 4.0W$	$V_{CC} = 24V$	16	—	—	W
$\eta_C$	$f = 2000 - 2300MHz$	$P_{IN} = 4.0W$	$V_{CC} = 24V$	40	—	—	%
$G_P$	$f = 2000 - 2300MHz$	$P_{IN} = 4.0W$	$V_{CC} = 24V$	6.0	—	—	dB

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



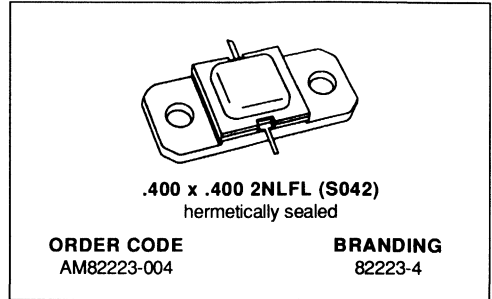
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
TELEMETRY APPLICATIONS**

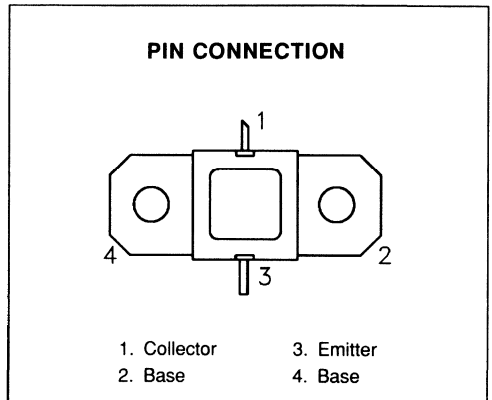
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty:1$  VSWR CAPABILITY AT RATED CONDITIONS
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 4$  W MIN. WITH 7.6 dB GAIN


**DESCRIPTION**

The AM82223-004 is a common base, silicon NPN bipolar transistor designed for high gain and efficiency in the 2.2 - 2.3 GHz frequency range.

Suitable for hi-rel aerospace telemetry applications, the AM82223-004 is provided in the industry-standard AMPAC™ metal/ceramic hermetic package and incorporates internal input and output impedance matching structures along with a rugged, emitter-site ballasted overlay die geometry.

AM82223-004 is capable of withstanding  $\infty:1$  load mismatch at any phase angle under full rated operating conditions.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	15.9	W
$I_C$	Device Current*	0.75	A
$V_{CC}$	Collector-Supply Voltage*	26	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	11	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

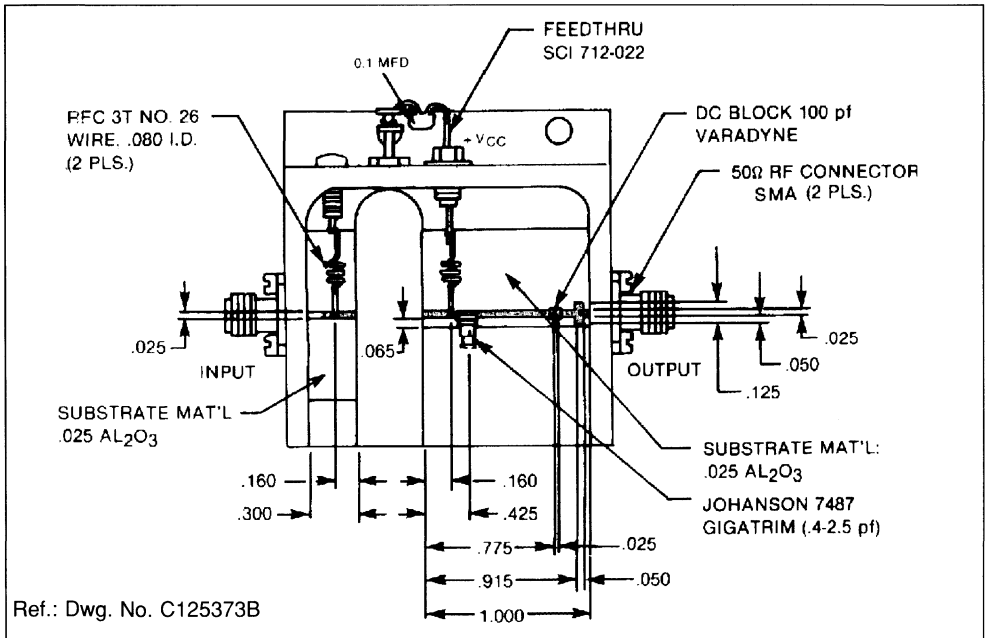
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 10mA$	$R_{BE} = 10\Omega$	40	—	—	V
$I_{CBO}$	$V_{CB} = 24V$		—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	20	—	—	—

DYNAMIC

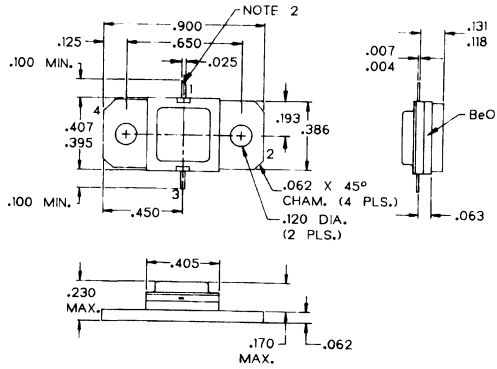
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.2 - 2.3GHz$	$P_{IN} = 0.70W$	$V_{CC} = 21V$	4.0	—	—	W
$\eta_c$	$f = 2.2 - 2.3GHz$	$P_{IN} = 0.70W$	$V_{CC} = 21V$	45	—	—	%
GP	$f = 2.2 - 2.3GHz$	$P_{IN} = 0.70W$	$V_{CC} = 21V$	7.6	—	—	dB

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



## NOTES:

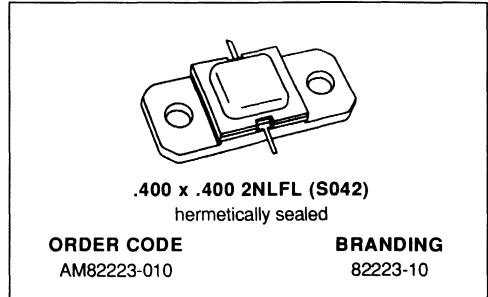
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.





**RF & MICROWAVE TRANSISTORS  
 TELEMETRY APPLICATIONS**

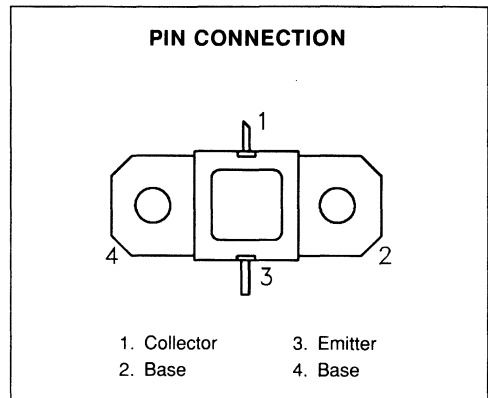
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty$ :1 VSWR CAPABILITY AT RATED CONDITIONS
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 9$  W MIN. WITH 6.5 dB GAIN


**DESCRIPTION**

The AM82223-010 is a common base, silicon NPN bipolar transistor designed for high gain and efficiency in the 2.2 - 2.3 GHz frequency range.

Suitable for hi-rel aerospace telemetry applications, the AM82223-010 is provided in the industry-standard AMPAC™ metal/ceramic hermetic package and incorporates internal input and output impedance matching structures along with a rugged, emitter-site ballasted overlay die geometry.

AM82223-010 is capable of withstanding  $\infty$ :1 load mismatch at any phase angle under full rated operating conditions.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 75^{\circ}C$ )	28	W
$I_C$	Device Current*	1.2	A
$V_{CC}$	Collector-Supply Voltage*	26	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	4.4	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

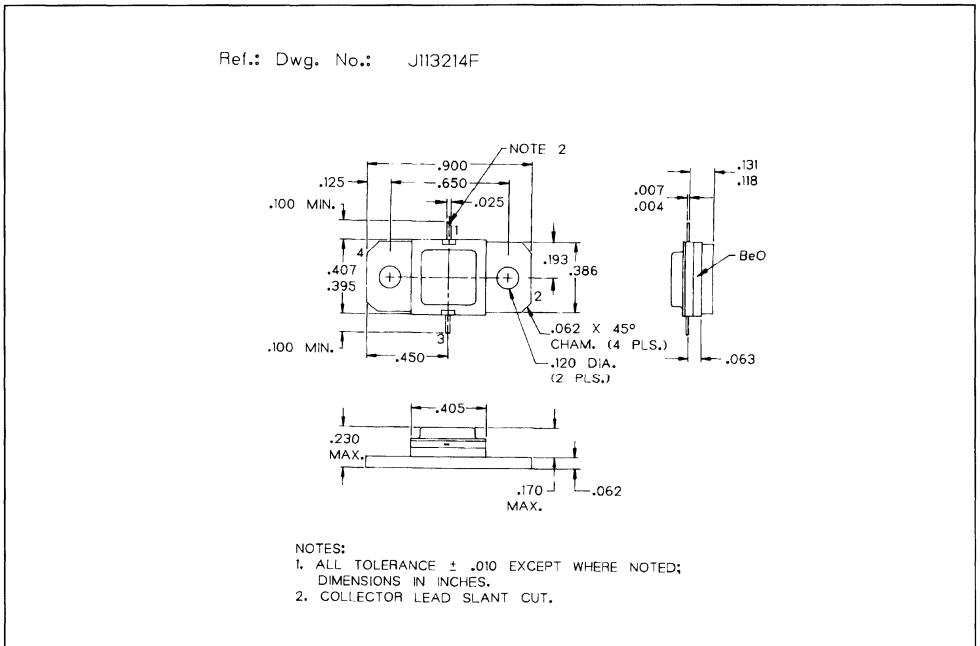
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 10mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 24V$		—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 750mA$	30	—	300	—

**DYNAMIC**

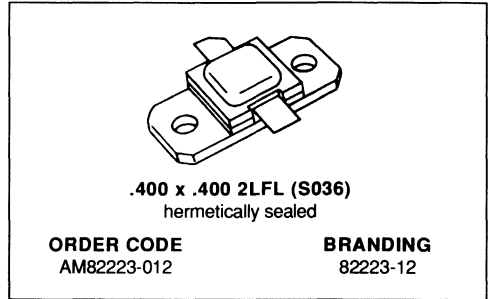
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.2 - 2.3GHz$	$P_{IN} = 2.0W$	$V_{CC} = 24V$	9.0	—	—	W
$\eta_C$	$f = 2.2 - 2.3GHz$	$P_{IN} = 2.0W$	$V_{CC} = 24V$	45	—	—	%
$G_P$	$f = 2.2 - 2.3GHz$	$P_{IN} = 2.0W$	$V_{CC} = 24V$	6.5	—	—	dB

**PACKAGE MECHANICAL DATA**



**RF & MICROWAVE TRANSISTORS  
 TELEMETRY APPLICATIONS**

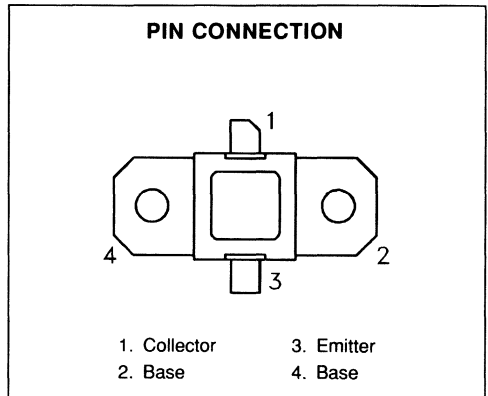
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty$ :1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 11$  W MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

The AM82223-012 is a common base, silicon NPN bipolar transistor designed for high gain and efficiency in the 2.2 - 2.3 GHz frequency range.

Suitable for hi-rel aerospace telemetry applications, the AM82223-012 is provided in the industry-standard AMPAC™ metal/ceramic hermetic package and incorporates internal input and output impedance matching structures along with a rugged, emitter-site ballasted overlay die geometry.

AM82223-012 is capable of withstanding  $\infty$ :1 load mismatch at any phase angle under full rated operating conditions.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	31.8	W
$I_c$	Device Current*	1.75	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.5	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot  
 Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

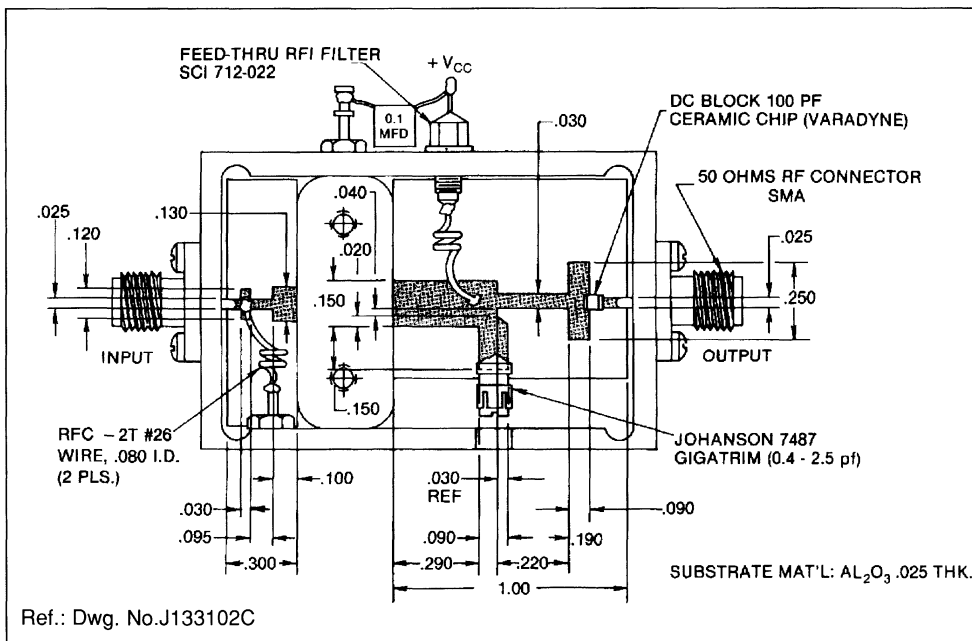
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 24V		—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = V	I <sub>C</sub> = mA	30	—	300	—

DYNAMIC

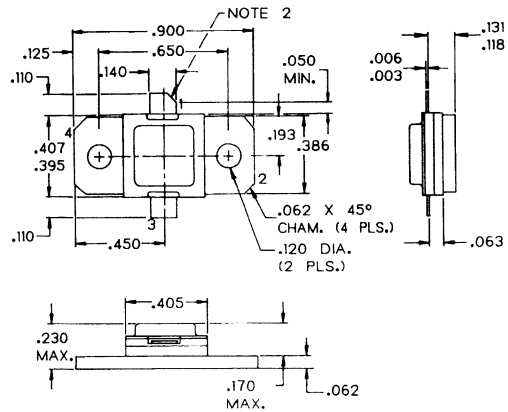
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2.2 — 2.3 GHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	11	—	—	W
η <sub>C</sub>	f = 2.2 — 2.3 GHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	40	—	—	%
G <sub>P</sub>	f = 2.2 — 2.3 GHz	P <sub>IN</sub> = 2.2W	V <sub>CC</sub> = 24V	7.0	—	—	dB

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



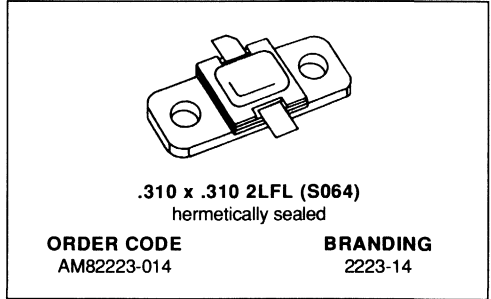
## NOTES:

1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 TELEMETRY APPLICATIONS**

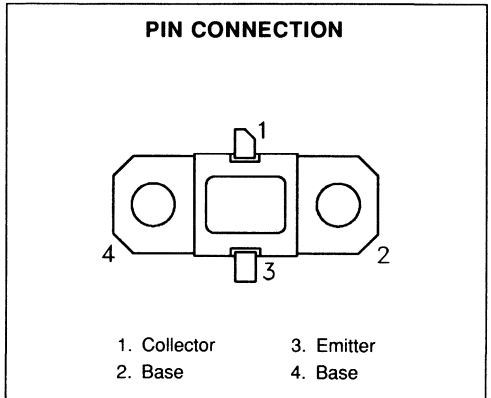
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty:1$  VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 12$  W MIN. WITH 7.6 dB GAIN


**DESCRIPTION**

The AM82223-014 is a common base, silicon NPN bipolar transistor designed for high gain and efficiency in the 2.2 - 2.3 GHz frequency range.

Suitable for hi-rel aerospace telemetry applications, the AM82223-014 is provided in the industry-standard AMPAC™ metal/ceramic hermetic package and incorporates internal input and output impedance matching structures along with a rugged, emitter-site ballasted overlay die geometry.

AM82223-014 is capable of withstanding an  $\infty:1$  load mismatch at any phase angle under full rated operating conditions.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 70^{\circ}C$ )	33	W
$I_C$	Device Current*	1.5	A
$V_{CC}$	Collector-Supply Voltage*	25	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.9	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

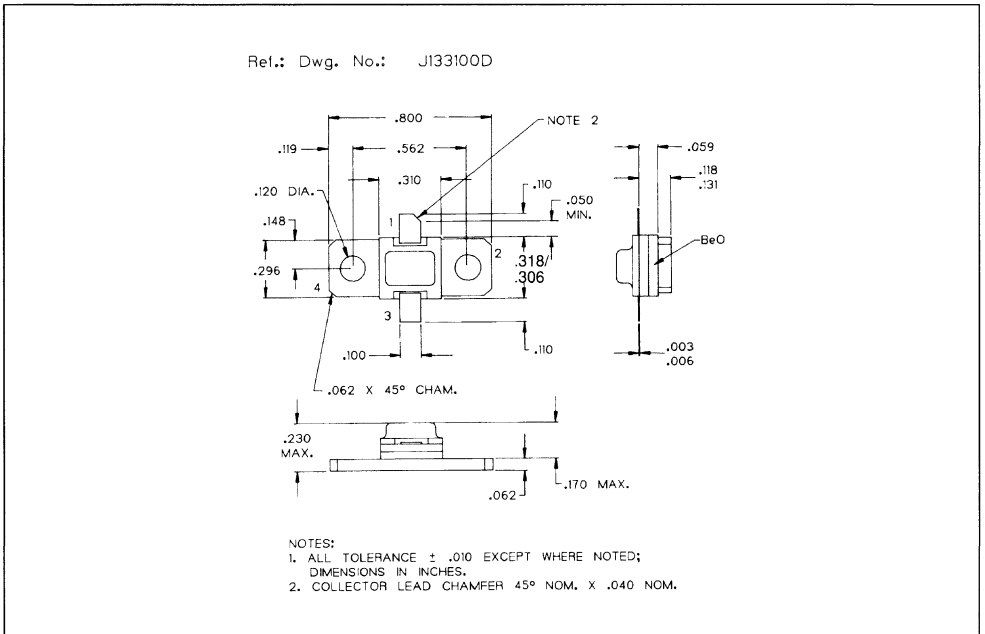
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 15mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1.5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 15mA$	$V_{BE} = 0V$	45	—	—	V
$I_{CES}$	$V_{CE} = 22V$		—	—	1.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	30	—	300	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.2 - 2.3GHz$	$P_{IN} = 2.1W$	$V_{CC} = 22V$	12	—	—	W
$\eta_C$	$f = 2.2 - 2.3GHz$	$P_{IN} = 2.1W$	$V_{CC} = 22V$	45	—	—	%
$G_P$	$f = 2.2 - 2.3GHz$	$P_{IN} = 2.1W$	$V_{CC} = 22V$	7.6	—	—	dB

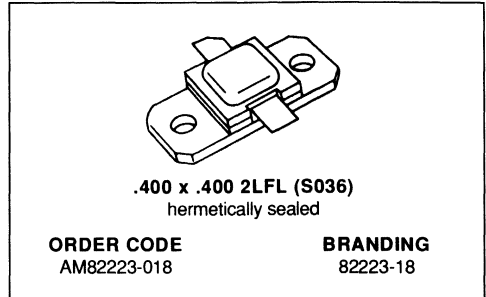
**PACKAGE MECHANICAL DATA**





## RF & MICROWAVE TRANSISTORS TELEMETRY APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty:1$  VSWR CAPABILITY AT RATED CONDITIONS
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 18$  W MIN. WITH 6.5 dB GAIN

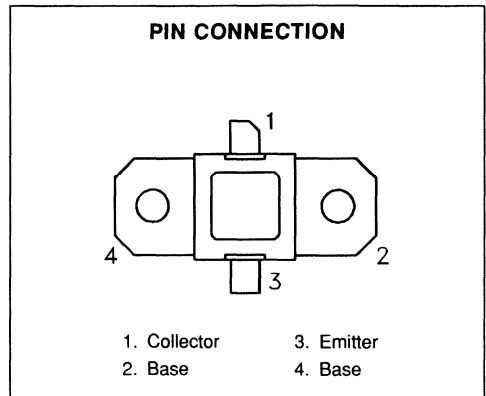


### DESCRIPTION

The AM82223-018 is a common base, silicon NPN bipolar transistor designed for high gain and efficiency in the 2.2 - 2.3 GHz frequency range.

Suitable for hi-rel aerospace telemetry applications, the AM82223-018 is provided in the industry-standard AMPAC™ metal/ceramic hermetic package and incorporates internal input and output impedance matching structures along with a rugged, emitter-site ballasted overlay die geometry.

AM82223-018 is capable of withstanding  $\infty:1$  load mismatch at any phase angle under full rated operating conditions.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	58.3	W
$I_C$	Device Current*	3.0	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	3.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal resistance determined by Infra-Red Scanning of Hot Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

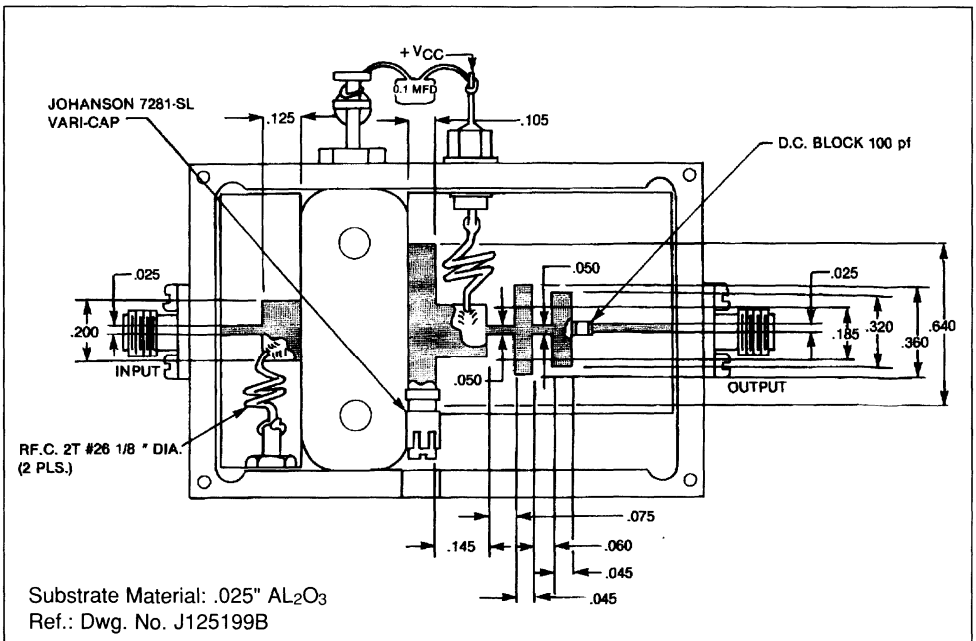
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{CB} = 24V$		—	—	2.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	30	—	300	—

DYNAMIC

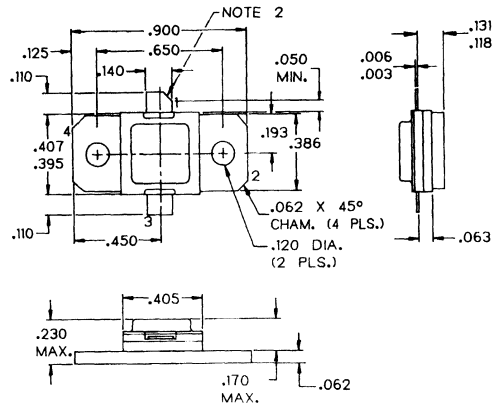
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.2 - 2.3GHz$	$P_{IN} = 4.0W$	$V_{CC} = 24V$	18	—	—	W
$\eta_c$	$f = 2.2 - 2.3GHz$	$P_{IN} = 4.0W$	$V_{CC} = 24V$	40	—	—	%
GP	$f = 2.2 - 2.3GHz$	$P_{IN} = 4.0W$	$V_{CC} = 24V$	6.5	—	—	dB

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



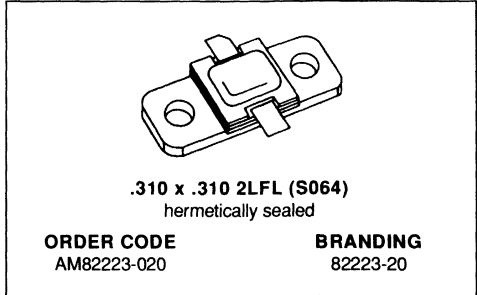
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



## RF & MICROWAVE TRANSISTORS TELEMETRY APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty$ :1 VSWR CAPABILITY AT RATED CONDITIONS
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 20$  W MIN. WITH 7.0 dB GAIN

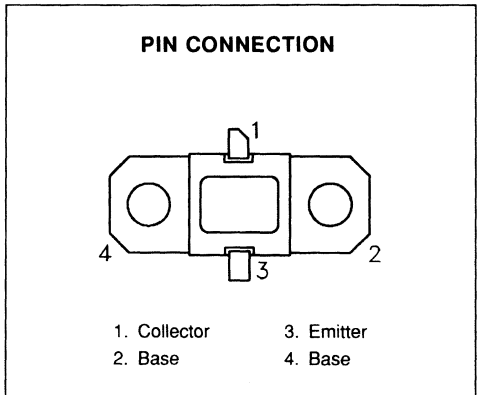


### DESCRIPTION

The AM82223-020 is a common base, silicon NPN bipolar transistor designed for high gain and efficiency in the 2.2 - 2.3 GHz frequency range.

Suitable for hi-rel aerospace telemetry applications, the AM82223-020 is provided in the industry-standard AMPAC™ metal/ceramic hermetic package and incorporates internal input and output impedance matching structures along with a rugged, emitter-site ballasted overlay die geometry.

AM82223-020 is capable of withstanding an  $\infty$ :1 load mismatch at any phase angle under full rated operating conditions.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	55	W
$I_C$	Device Current*	3	A
$V_{CC}$	Collector-Supply Voltage*	25	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.7	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

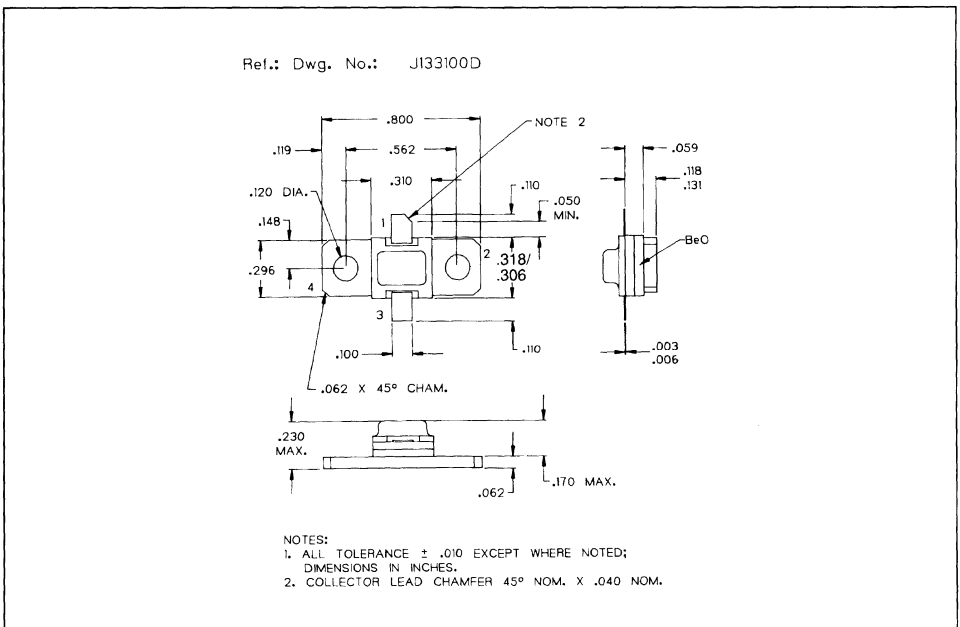
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 12mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 2.5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 22V$		—	—	2.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	30	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.2 - 2.3GHz$	$P_{IN} = 4.0W$	$V_{CC} = 22V$	20	—	—	W
$\eta_C$	$f = 2.2 - 2.3GHz$	$P_{IN} = 4.0W$	$V_{CC} = 22V$	40	—	—	%
$G_P$	$f = 2.2 - 2.3GHz$	$P_{IN} = 4.0W$	$V_{CC} = 22V$	7.0	—	—	dB

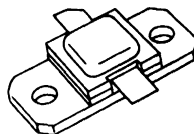
PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
TELEMETRY APPLICATIONS**

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 20$  W MIN. WITH 6.0 dB GAIN


**.400 x .400 2LFL (S036)**  
hermetically sealed

**ORDER CODE**  
AM82324-020

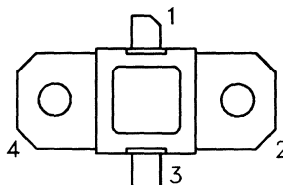
**BRANDING**  
82324-20

**DESCRIPTION**

The AM82324-020 is a common base NPN silicon bipolar transistor optimized for high gain and efficiency in the 2.3 - 2.4 GHz frequency range.

Designed for Class C, CW power amplifier application, the AM82324-020 utilizes a rugged, emitter-ballasted, gold metallized die geometry for low thermal resistance and excellent long term reliability.

AM82324-020 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	60	W
$I_C$	Device Current*	3	A
$V_{CC}$	Collector-Supply Voltage*	25	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.5	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

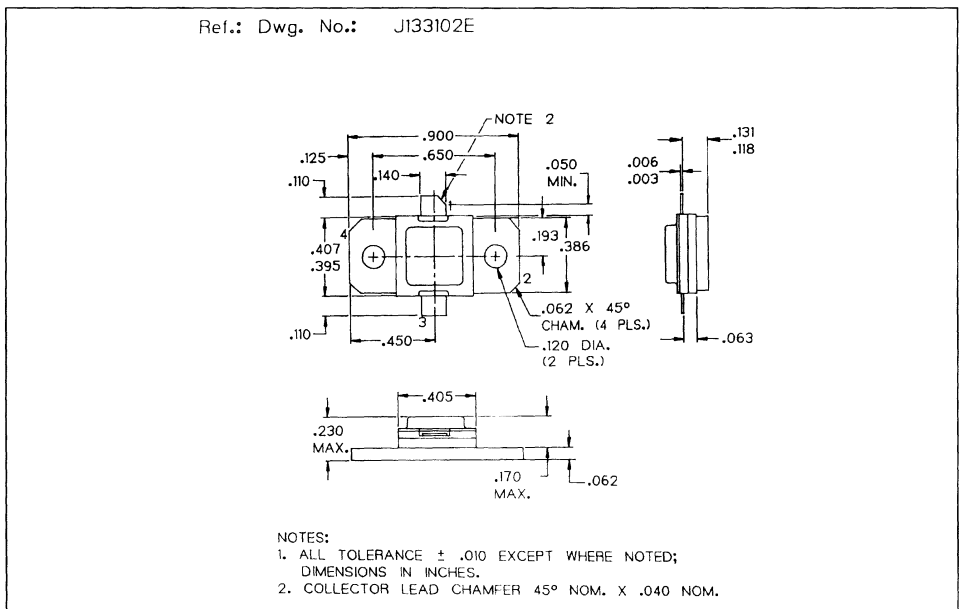
**STATIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$		45	—	—	V
$BV_{EBO}$	$I_E = 2.5mA$	$I_C = 0mA$		3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$		45	—	—	V
$I_{CBO}$	$V_{CB} = 22V$			—	—	2.5	mA
$h_{FE}$	DC Current Gain	$V_{CE} = 5V$	$I_C = 2A$	30	—	300	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.3 - 2.4GHz$	$P_{IN} = 5.0W$	$V_{CC} = 22V$	20	—	—	W
$\eta_c$	$f = 2.3 - 2.4GHz$	$P_{IN} = 5.0W$	$V_{CC} = 22V$	2.5	—	—	%
GP	$f = 2.3 - 2.4GHz$	$P_{IN} = 5.0W$	$V_{CC} = 22V$	6.0	—	—	dB

**PACKAGE MECHANICAL DATA**

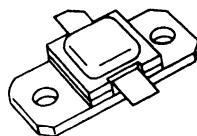




**RF & MICROWAVE TRANSISTORS  
S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 40$  W MIN. WITH 6.0 dB GAIN



**.400 x .400 2LFL (S036)**  
hermetically sealed

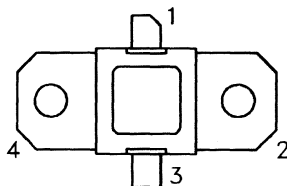
**ORDER CODE**  
AM82325-040

**BRANDING**  
82325-40

**DESCRIPTION**

The AM82325-040 is a high power silicon NPN bipolar device optimized for specialized pulsed applications in the 2.3 - 2.5 GHz frequency range.

AM82325-040 incorporates computerized automatic wire bonding for high reliability and product consistency and is supplied in the industry-standard AMPAC™ input/output matched package.

**PIN CONNECTION**


1. Collector                      3. Emitter  
2. Base                            4. Base

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	220	W
$I_C$	Device Current*	8.0	A
$V_{CC}$	Collector-Supply Voltage*	40	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.90	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{CE} = 35V$		—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	30	—	—	—

**DYNAMIC**

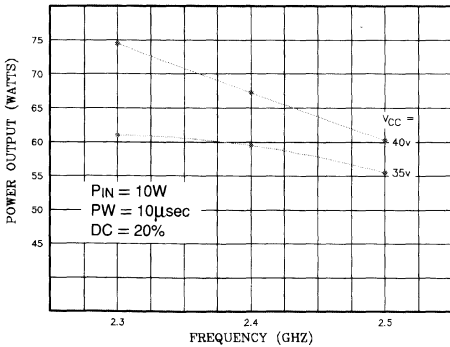
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.3 - 2.5GHz$	$P_{IN} = 10W$	$V_{CC} = 35V$	40	—	—	W
$\eta_C$	$f = 2.3 - 2.5GHz$	$P_{IN} = 10W$	$V_{CC} = 35V$	40	—	—	%
$G_P$	$f = 2.3 - 2.5GHz$	$P_{IN} = 10W$	$V_{CC} = 35V$	6.0	—	—	dB

Note: Pulse Width =  $10\mu Sec$

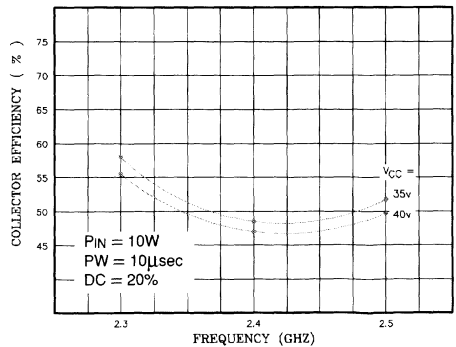
Duty Cycle = 20%

**TYPICAL PERFORMANCE**

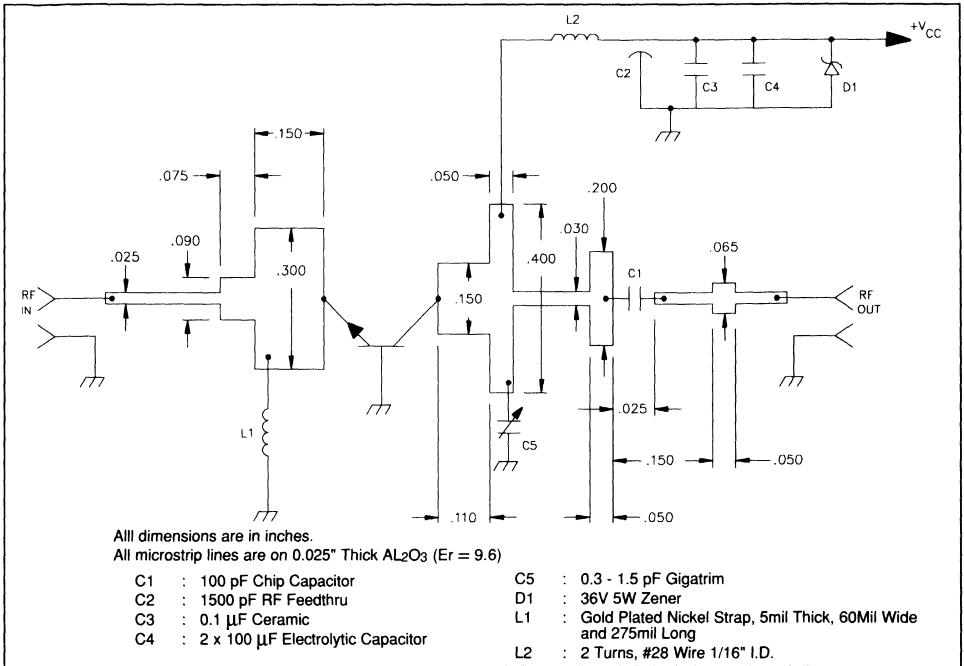
**POWER OUTPUT vs FREQUENCY**



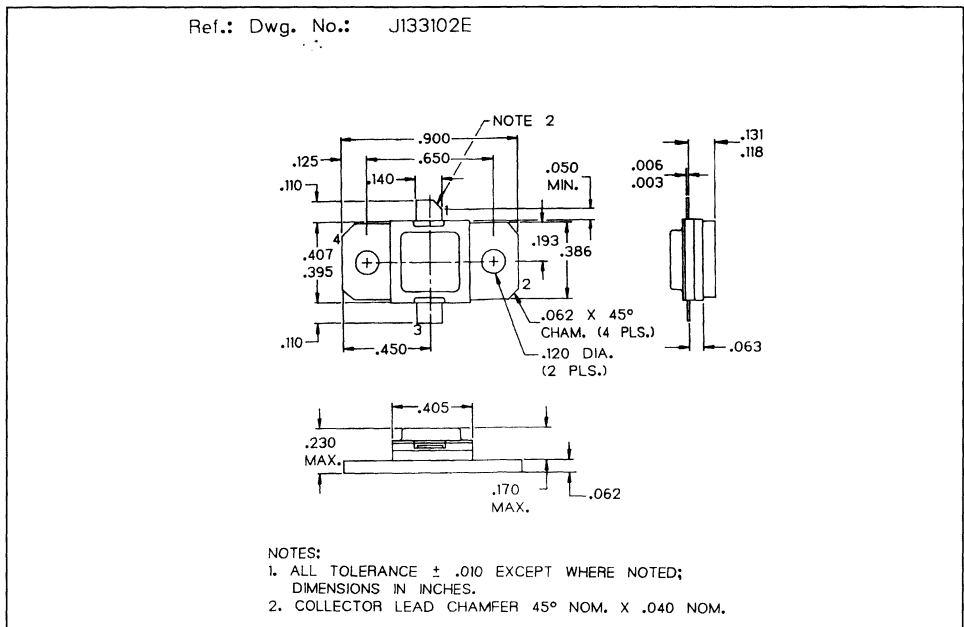
**COLLECTOR EFFICIENCY vs FREQUENCY**



TEST CIRCUIT



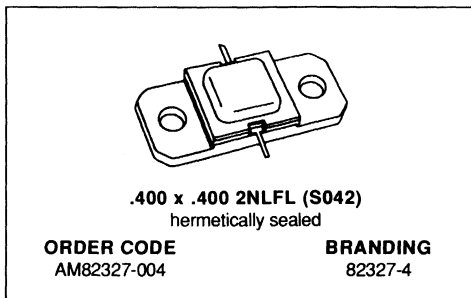
PACKAGE MECHANICAL DATA





## RF & MICROWAVE TRANSISTORS COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 4 \text{ W}$  MIN. WITH 6.0 dB GAIN

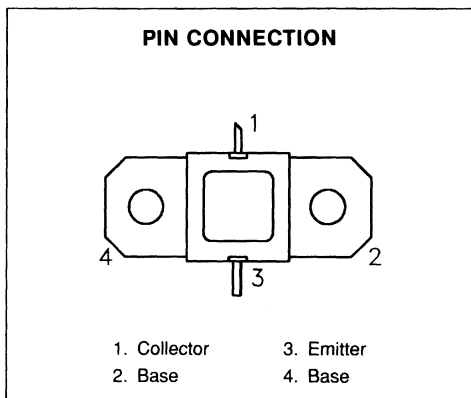


### DESCRIPTION

The AM82327-004 is a common base NPN silicon bipolar transistor optimized for high gain and efficiency in the 2.3 - 2.7 GHz frequency range.

Ideal for Class C telecommunications applications, the AM82327-004 utilizes an emitter-ballasted, gold-metallized die geometry for low thermal resistance and outstanding long term reliability.

AM82327-004 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	15.9	W
$I_C$	Device Current*	0.75	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	11	$^{\circ}\text{C}/\text{W}$
---------------	-----------------------------------	----	-----------------------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

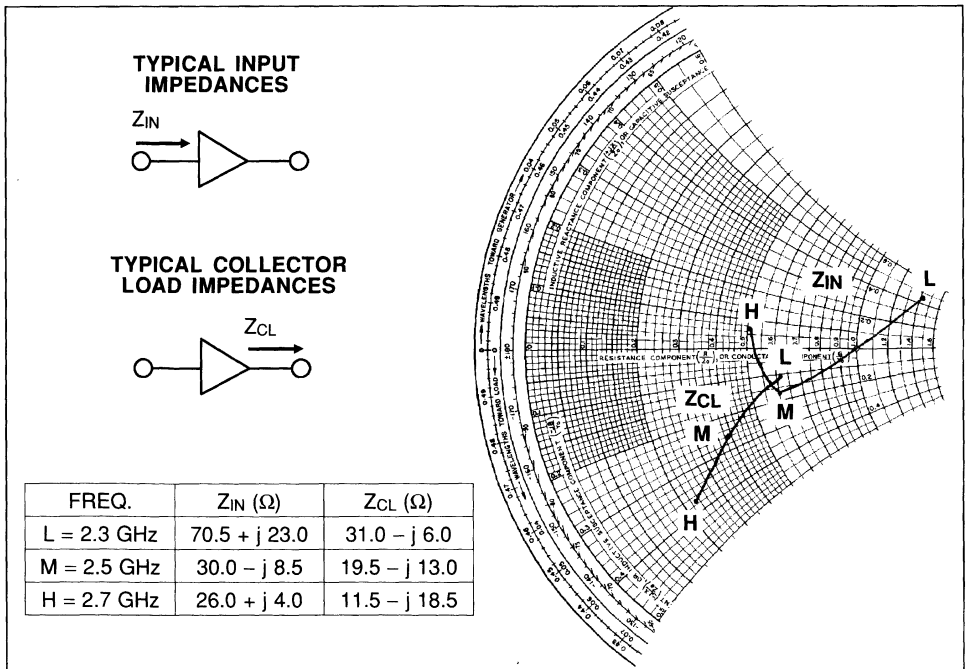
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{CB} = 24V$		—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	20	—	—	—

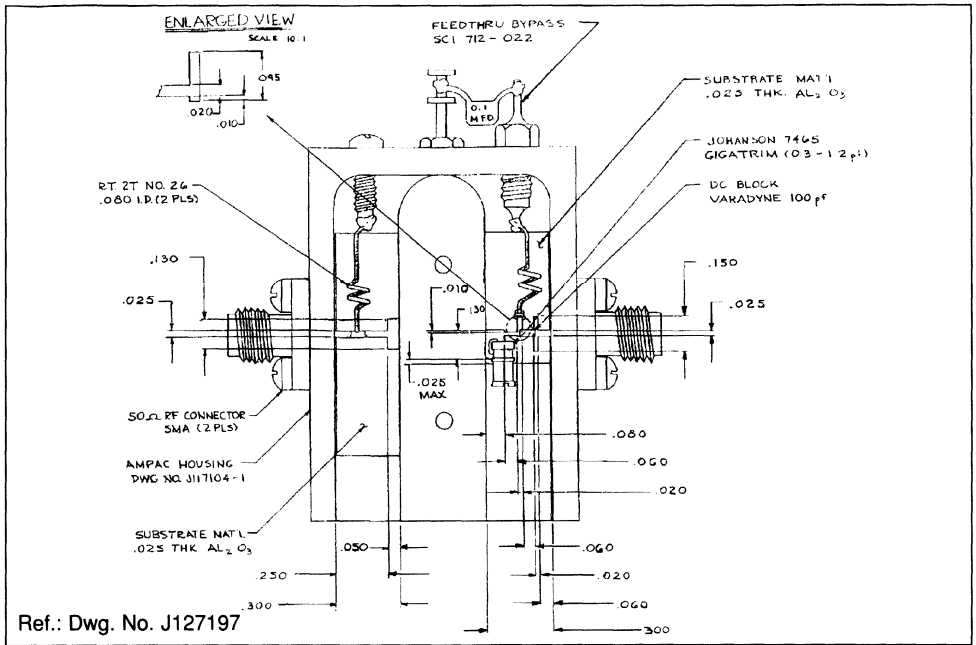
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2300 - 2700MHz$	$P_{IN} = 1.0W$	$V_{CC} = 24V$	4.0	—	—	W
$\eta_C$	$f = 2300 - 2700MHz$	$P_{IN} = 1.0W$	$V_{CC} = 24V$	30	—	—	%
GP	$f = 2300 - 2700MHz$	$P_{IN} = 1.0W$	$V_{CC} = 24V$	6.0	—	—	dB

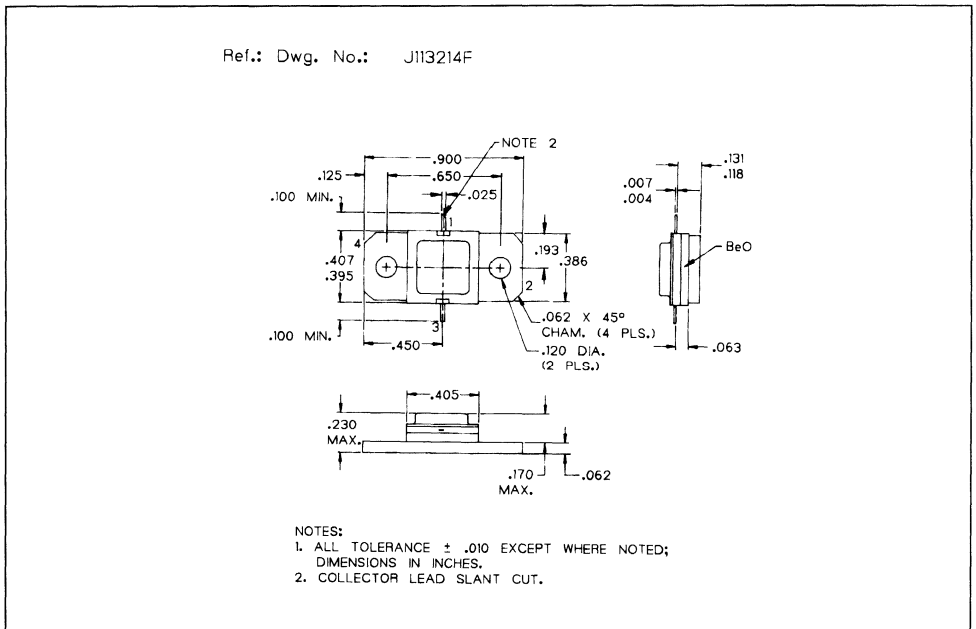
**IMPEDANCE DATA**



TEST CIRCUIT



PACKAGE MECHANICAL DATA

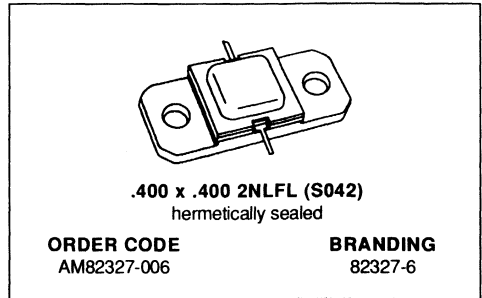






**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

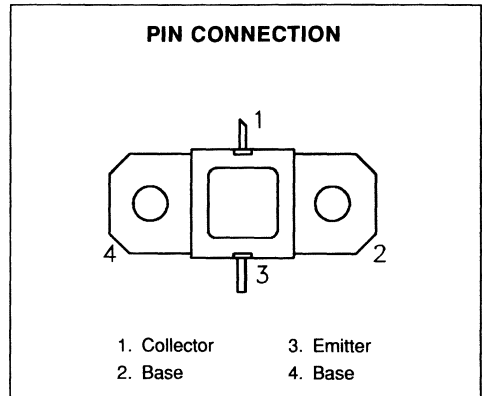
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 6 \text{ W MIN. WITH } 5.4 \text{ dB GAIN}$


**DESCRIPTION**

The AM82327-006 is a common base NPN silicon bipolar transistor optimized for high gain and efficiency in the 2.3 - 2.7 GHz frequency range.

Ideal for Class C telecommunications applications, the AM82327-006 utilizes an emitter-ballasted, gold-metallized die geometry for low thermal resistance and outstanding long term reliability.

AM82327-006 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	19.4	W
$I_c$	Device Current*	1.1	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	9.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

Note: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

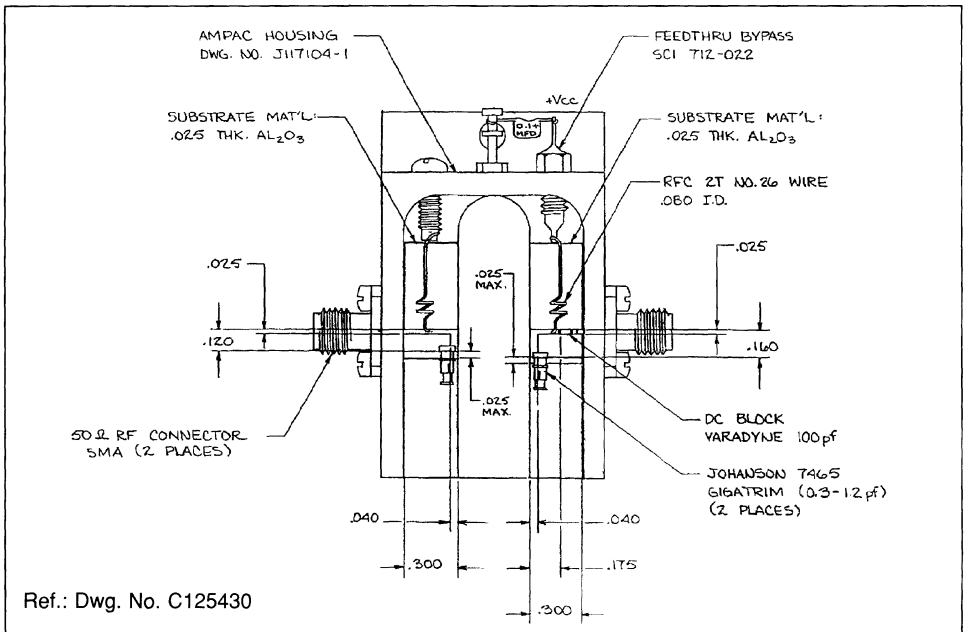
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CB0</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	40	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CB0</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 24V	—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500mA	20	—	—	—

DYNAMIC

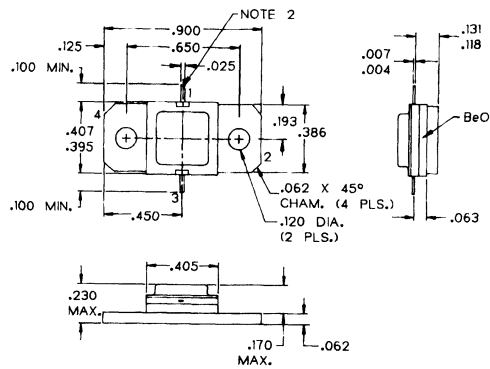
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2.3 — 2.7GHz	P <sub>IN</sub> = 1.75W	V <sub>CC</sub> = 24V	6.0	—	—	W
η <sub>C</sub>	f = 2.3 — 2.7GHz	P <sub>IN</sub> = 1.75W	V <sub>CC</sub> = 24V	30	—	—	%
G <sub>P</sub>	f = 2.3 — 2.7GHz	P <sub>IN</sub> = 1.75W	V <sub>CC</sub> = 24V	5.4	—	—	dB

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

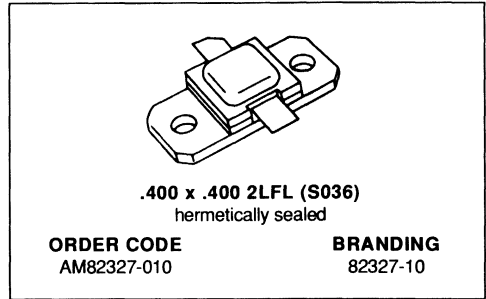
Ref.: Dwg. No.: J113214F





**RF & MICROWAVE TRANSISTORS  
 COMMUNICATIONS APPLICATIONS**

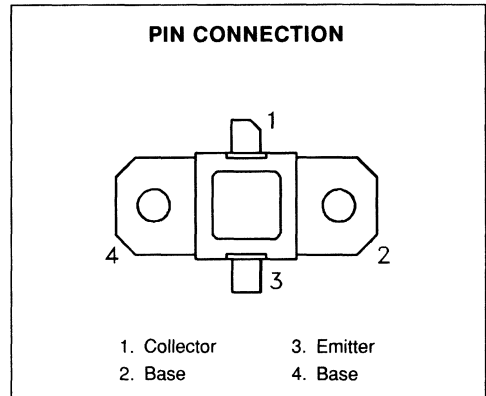
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 9$  W MIN. WITH 5.2 dB GAIN


**DESCRIPTION**

The AM82327-010 is a common base NPN silicon bipolar transistor optimized for high gain and efficiency in the 2.3 - 2.7 GHz frequency range.

Ideal for Class C telecommunications applications, the AM82327-010 utilizes an emitter-ballasted, gold metallized die geometry for low thermal resistance and outstanding long term reliability.

AM82327-010 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	31.8	W
$I_C$	Device Current*	1.75	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	5.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot  
 Junction Temperature at rated RF operating conditions

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

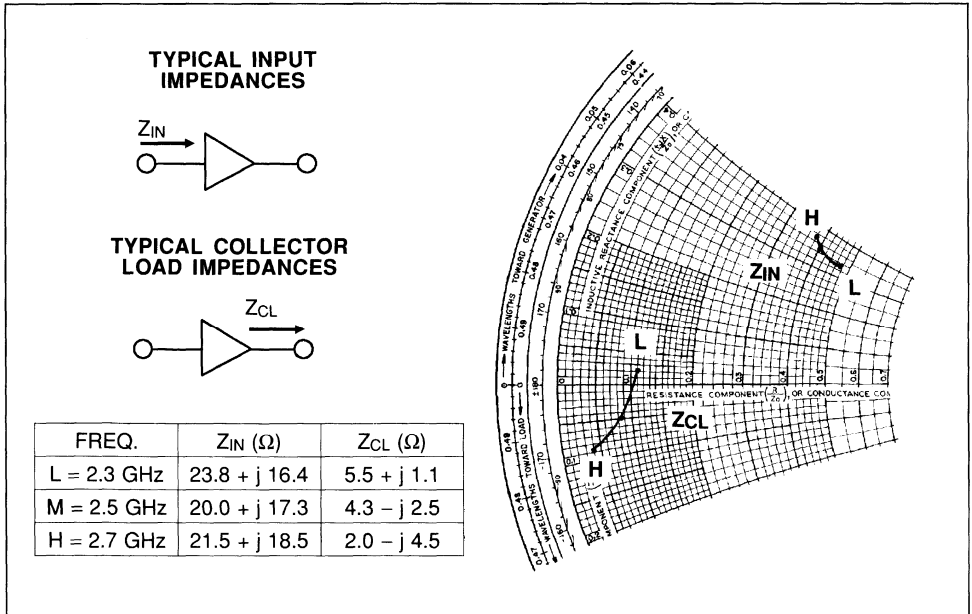
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CB0</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	40	—	—	V
BV <sub>EB0</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CB0</sub>	V <sub>CB</sub> = 24V		—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	20	—	300	—

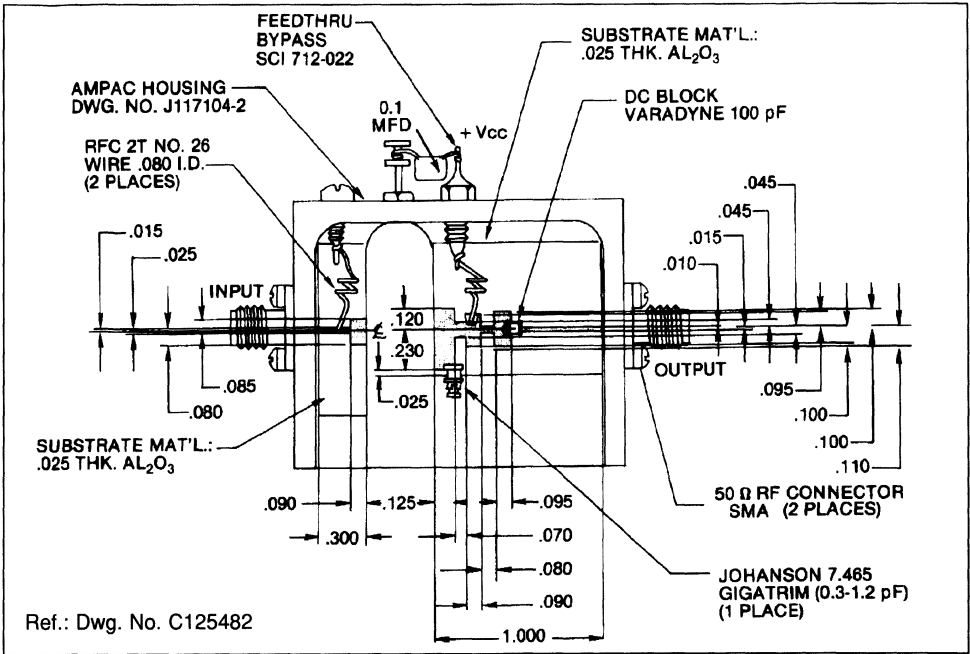
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2300 — 2700MHz	P <sub>IN</sub> = 2.75W	V <sub>CC</sub> = 24V	9.0	—	—	W
η <sub>C</sub>	f = 2300 — 2700MHz	P <sub>IN</sub> = 2.75W	V <sub>CC</sub> = 24V	30	—	—	%
G <sub>P</sub>	f = 2300 — 2700MHz	P <sub>IN</sub> = 2.75W	V <sub>CC</sub> = 24V	5.2	—	—	dB

IMPEDANCE DATA

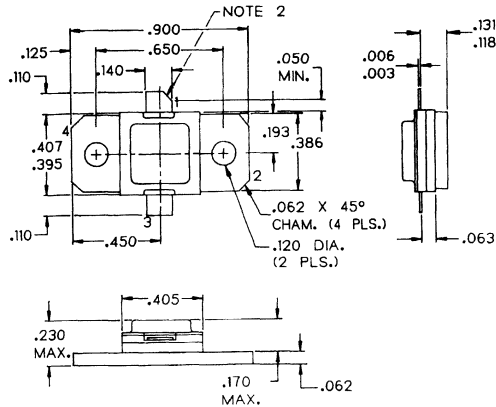


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



NOTES:

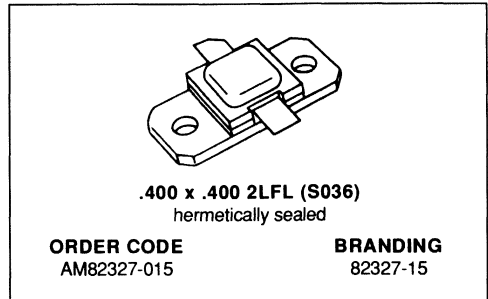
1. ALL TOLERANCE ± .010 EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.





## RF & MICROWAVE TRANSISTORS COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 15$  W MIN. WITH 4.0 dB GAIN

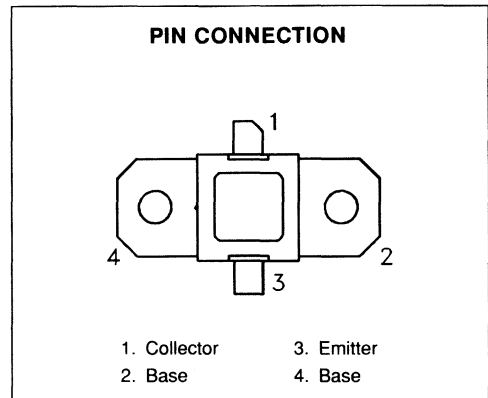


### DESCRIPTION

The AM82327-015 is a common base NPN silicon bipolar transistor optimized for high gain and efficiency in the 2.3 - 2.7 GHz frequency range.

Ideal for Class C telecommunications applications, the AM82327-015 utilizes an emitter-ballasted, gold metallized die geometry for low thermal resistance and outstanding long term reliability.

AM82327-015 is provided in the industry-standard AMPAC™ metal/ceramic, hermetic package.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	58.3	W
$I_C$	Device Current*	3.0	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	3.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

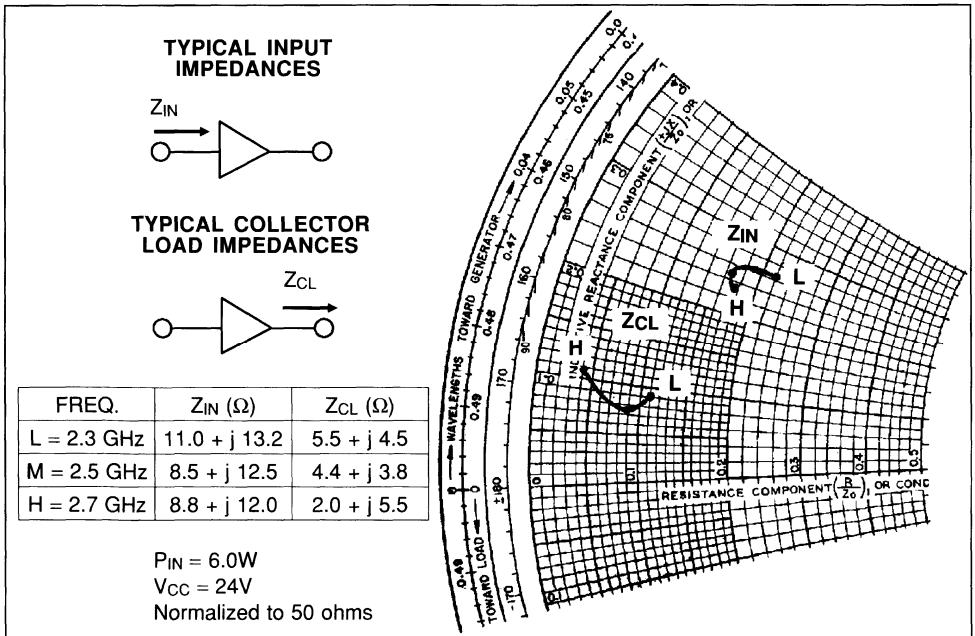
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	40	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 24V		—	—	2	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 2A	20	—	900	—

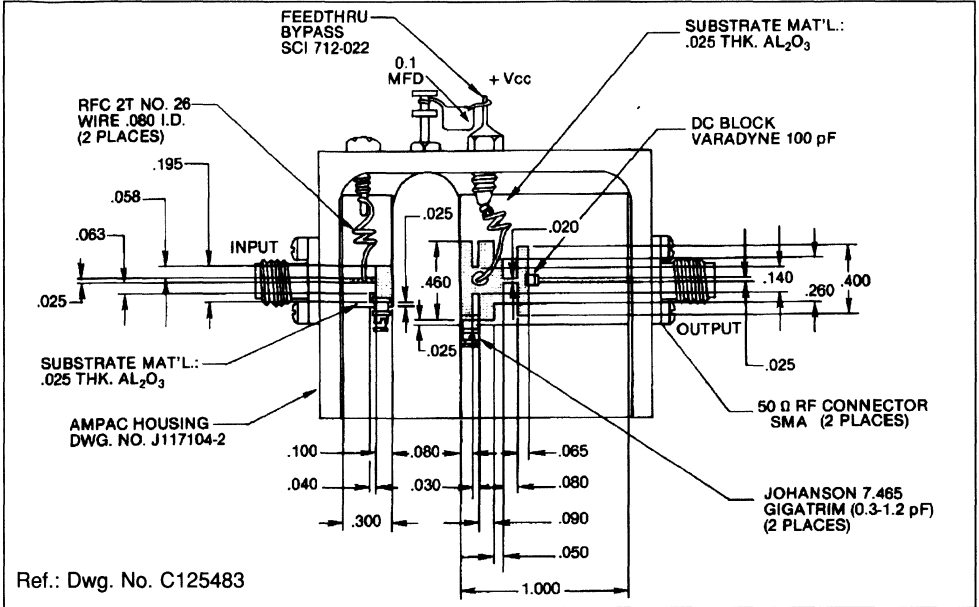
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2300 — 2700MHz	P <sub>IN</sub> = 6.0W	V <sub>CC</sub> = 24V	15.0	—	—	W
η <sub>c</sub>	f = 2300 — 2700MHz	P <sub>IN</sub> = 6.0W	V <sub>CC</sub> = 24V	30	—	—	%
G <sub>P</sub>	f = 2300 — 2700MHz	P <sub>IN</sub> = 6.0W	V <sub>CC</sub> = 24V	4.0	—	—	dB

IMPEDANCE DATA

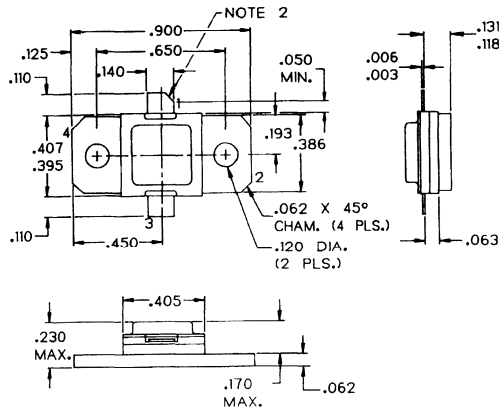


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



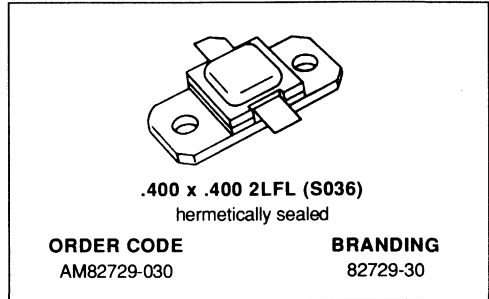
NOTES:

1. ALL TOLERANCE ± .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

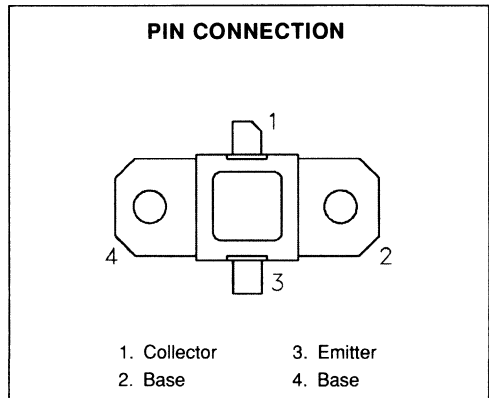
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 28$  W MIN. WITH 6.5 dB GAIN


**DESCRIPTION**

The AM82729-030 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and can withstand a 3:1 output VSWR with a +1 dB input over drive. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM82729-030 is supplied in the Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	107	W
$I_c$	Device Current*	4	A
$V_{CC}$	Collector-Supply Voltage*	48	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.4	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** (T<sub>case</sub> = 25°C)

**STATIC**

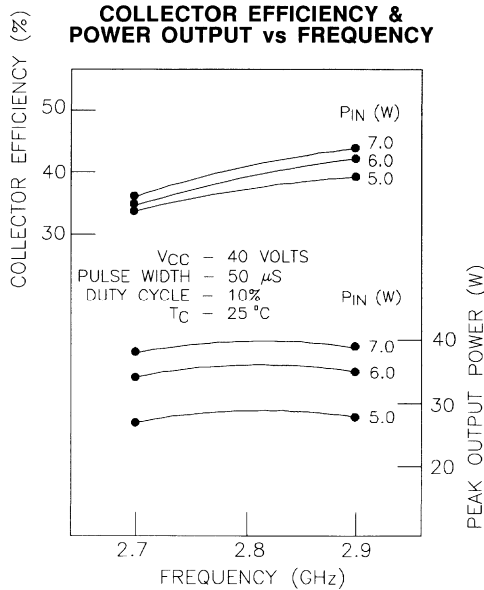
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 15mA	I <sub>E</sub> = 0mA	55	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 2mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 15mA	R <sub>BE</sub> = 10Ω	55	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 40V		—	—	10	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1.5A	30	—	—	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2700 — 2900MHz	P <sub>IN</sub> = 6.3W	V <sub>CC</sub> = 40V	28	—	—	W
η <sub>c</sub>	f = 2700 — 2900MHz	P <sub>IN</sub> = 6.3W	V <sub>CC</sub> = 40V	30	—	—	%
G <sub>P</sub>	f = 2700 — 2900MHz	P <sub>IN</sub> = 6.3W	V <sub>CC</sub> = 40V	6.5	—	—	dB

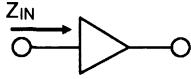
Note: Pulse Width = 50μSec  
 Duty Cycle = 10%

**TYPICAL PERFORMANCE**

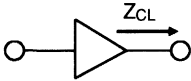


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



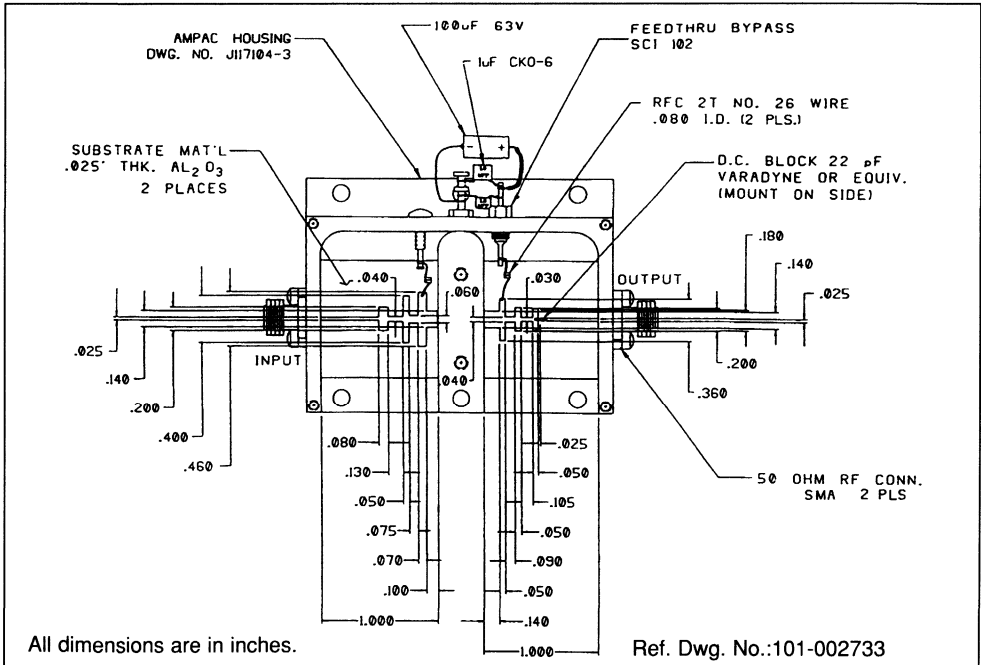
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	12 + j 3.0	15.0 - j 4.0
M = 2.8 GHz	4.5 + j 2.5	17.0 - j 3.0
H = 2.9 GHz	6.5 + j 0.0	15.5 - j 3.0

P<sub>IN</sub> = 6.3 W  
 V<sub>CC</sub> = 40 V  
 Normalized to 50 ohms

TEST CIRCUIT

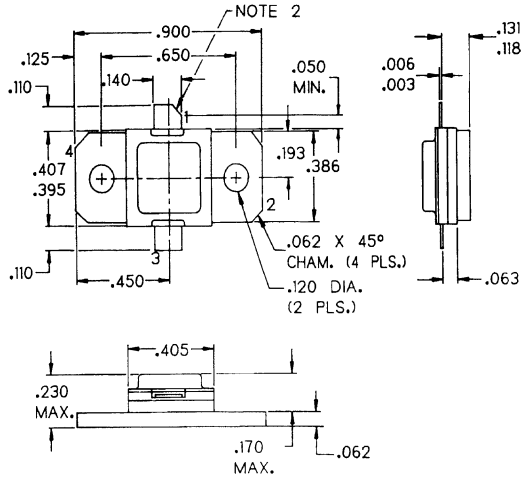


All dimensions are in inches.

Ref. Dwg. No.:101-002733

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



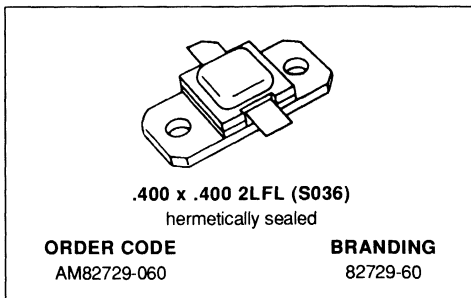
NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

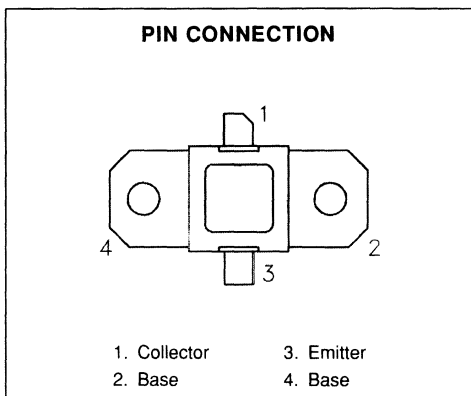
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- VSWR 3:1 @ +1dB OVERDRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 60 W MIN. WITH 6.6 dB GAIN


**DESCRIPTION**

The AM82729-060 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and can withstand a 3:1 VSWR with a +1dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM82729-060 is supplied in the Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 100°C)	300	W
I <sub>c</sub>	Device Current*	8	A
V <sub>CC</sub>	Collector-Supply Voltage*	48	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.50	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{CE} = 40V$		—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	30	—	—	—

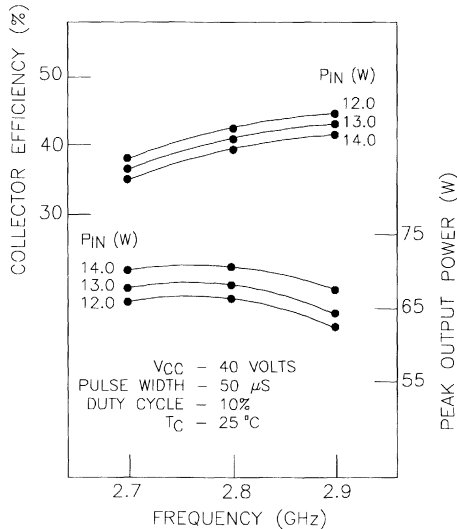
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2700 - 2900MHz$	$P_{IN} = 13W$	$V_{CC} = 40V$	60	—	—	W
$\eta_C$	$f = 2700 - 2900MHz$	$P_{IN} = 13W$	$V_{CC} = 40V$	35	—	—	%
$G_P$	$f = 2700 - 2900MHz$	$P_{IN} = 13W$	$V_{CC} = 40V$	6.6	—	—	dB

Note: Pulse Width = 50 $\mu$ Sec  
 Duty Cycle = 10%

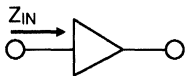
**TYPICAL PERFORMANCE**

**POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**

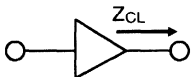


IMPEDANCE DATA

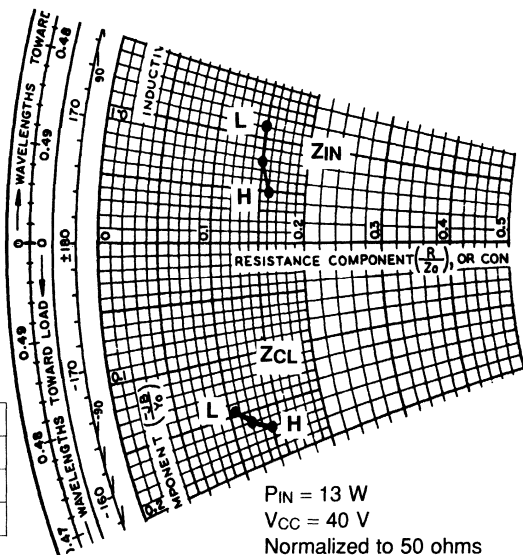
TYPICAL INPUT IMPEDANCE



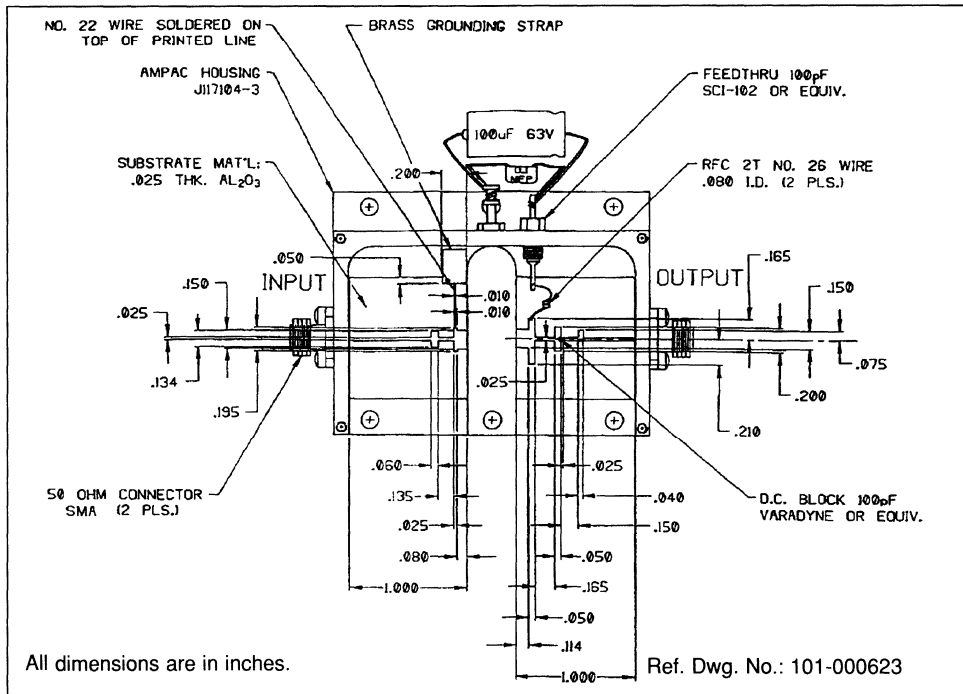
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	7.4 + j 5.4	7.1 - j 8.6
M = 2.8 GHz	7.6 + j 4.1	6.0 - j 8.0
H = 2.9 GHz	7.8 + j 3.0	5.4 - j 7.4



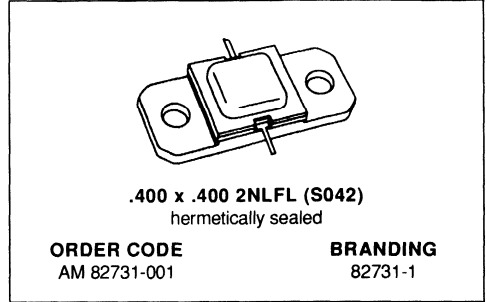
TEST CIRCUIT





## RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT IMPEDANCE MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 1.0$  W. MIN. WITH 5.2 dB GAIN
- BANDWIDTH = 400 MHz

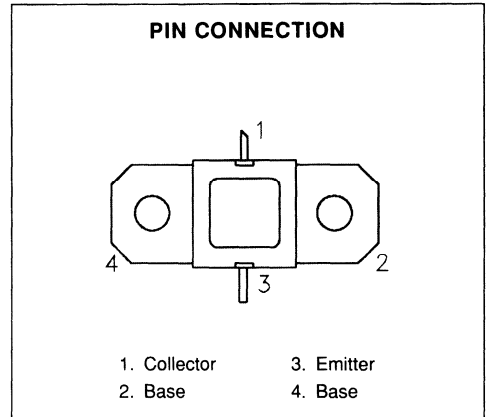


### DESCRIPTION

The AM82731-001 device is a medium power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and can withstand a 10:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency.

The AM82731-001 is supplied in the hermetic metal/ceramic package with internal input/output impedance matching circuitry, and is intended for military and other high reliability applications.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	11.5	W
$I_c$	Device Current*	0.45	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	13.0	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 1mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CES}$	$V_{CE} = 30V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	10	—	—	—

Specifications subject to change without notice

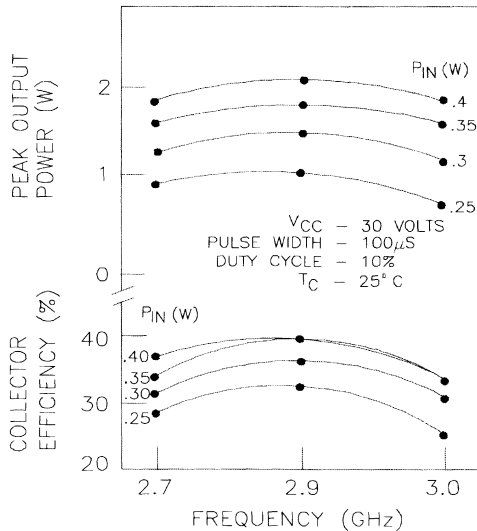
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.7 - 3.1 GHz$	$P_{IN} = 0.3W$	$V_{CC} = 30V$	1.0	1.1	—	W
$\eta_C$	$f = 2.7 - 3.1 GHz$	$P_{IN} = 0.3W$	$V_{CC} = 30V$	27	30	—	%
GPB	$f = 2.7 - 3.1 GHz$	$P_{IN} = 0.3W$	$V_{CC} = 30V$	5.2	5.6	—	dB

Note: Pulse Width = 100  $\mu$ S  
 Duty Cycle = 10%

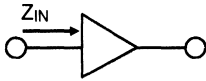
**TYPICAL PERFORMANCE**

**TYPICAL BROADBAND PERFORMANCE**

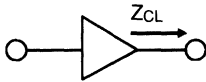


IMPEDANCE DATA

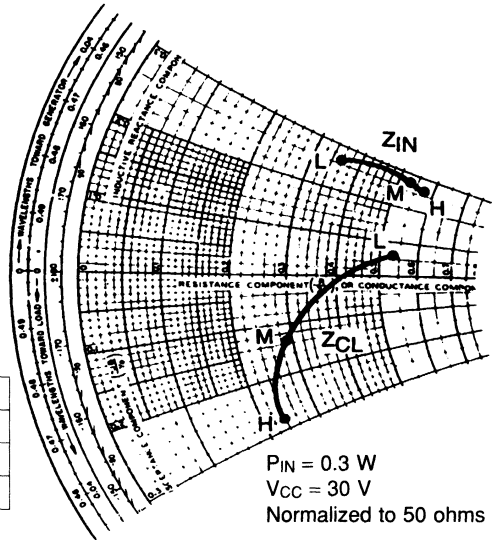
TYPICAL INPUT IMPEDANCES



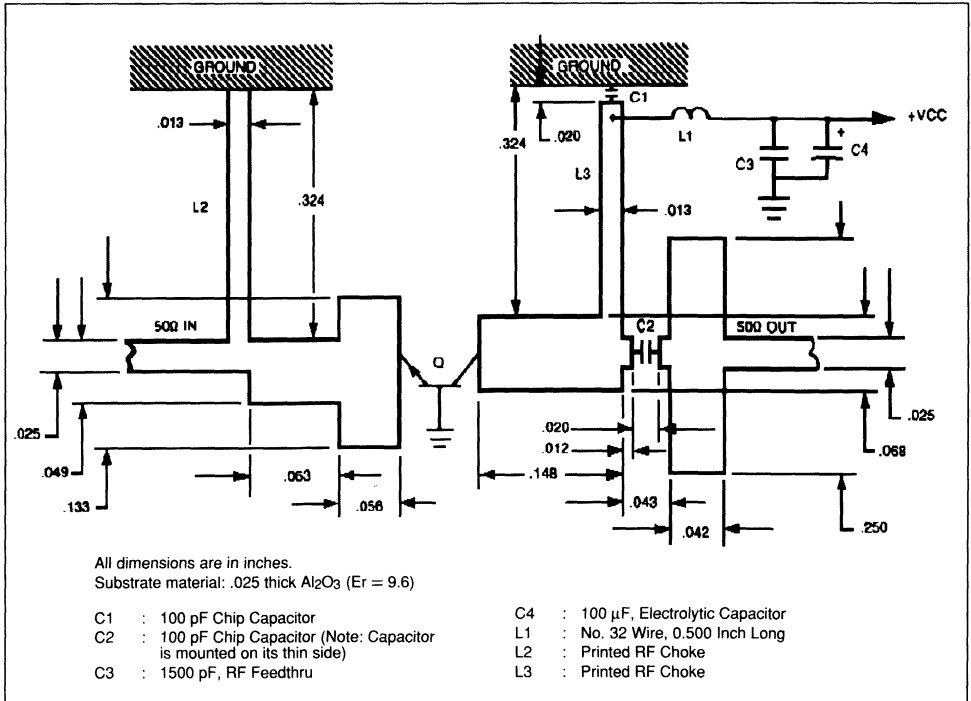
TYPICAL COLLECTOR LOAD IMPEDANCES



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	18.0 + j 23.5	27.0 + j 3.0
M = 2.9 GHz	24.0 + j 23.5	14.0 - j 6.5
H = 3.1 GHz	28.0 + j 23.0	12.0 - j 14.0

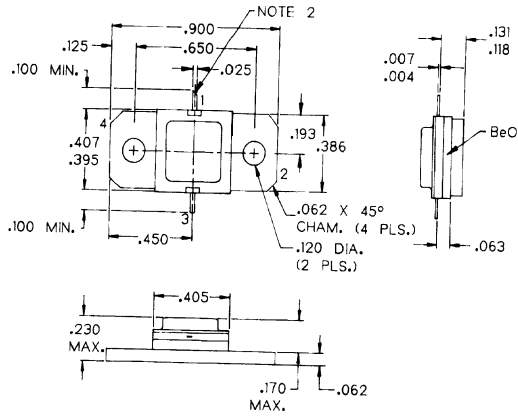


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F

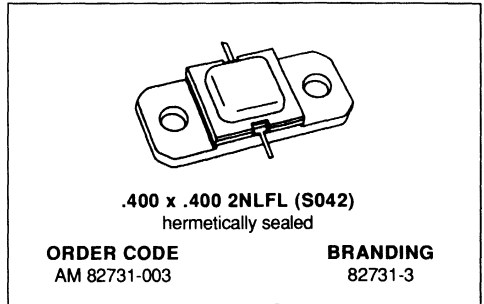


- NOTES:  
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.  
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

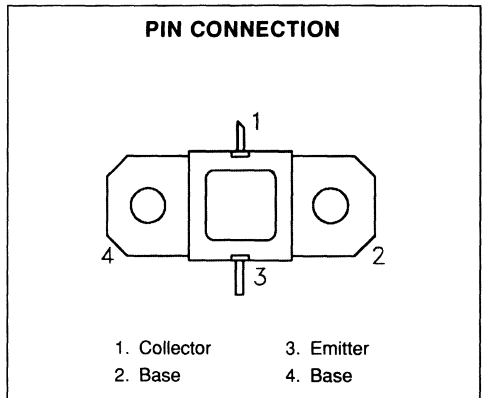
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT IMPEDANCE MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 3.0$  W. MIN. WITH 5.7 dB GAIN
- BANDWIDTH = 400 MHz


**DESCRIPTION**

The AM82731-003 device is a medium power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and can withstand a 10:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency.

The AM82731-003 is supplied in the hermetic metal/ceramic package with internal input/output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	23	W
$I_c$	Device Current*	0.9	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	6.5	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 2mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 2mA$	$R_{BE} = 10\Omega$	50	—	—	V
$I_{CES}$	$V_{CE} = 30V$		—	—	2.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 200mA$	10	—	—	—

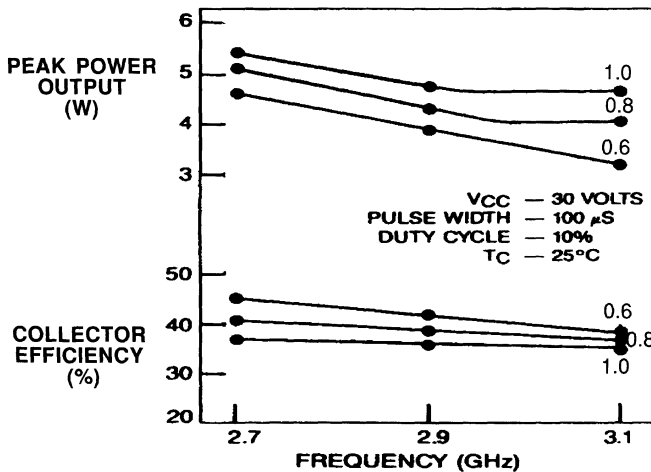
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.7 - 3.1GHz$	$P_{IN} = 0.8W$	$V_{CC} = 30V$	3.0	4.0	—	W
$\eta_C$	$f = 2.7 - 3.1GHz$	$P_{IN} = 0.8W$	$V_{CC} = 30V$	27	37	—	%
GPB	$f = 2.7 - 3.1GHz$	$P_{IN} = 0.8W$	$V_{CC} = 30V$	5.7	7.0	—	dB

Note: Pulse Width = 100 $\mu$ S  
 Duty Cycle = 10%

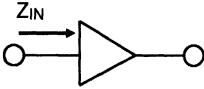
**TYPICAL PERFORMANCE**

**TYPICAL BROADBAND PERFORMANCE**

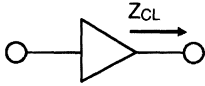


**IMPEDANCE DATA**

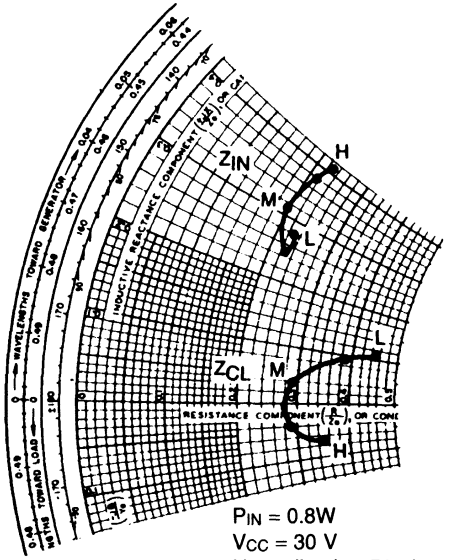
**TYPICAL INPUT IMPEDANCES**



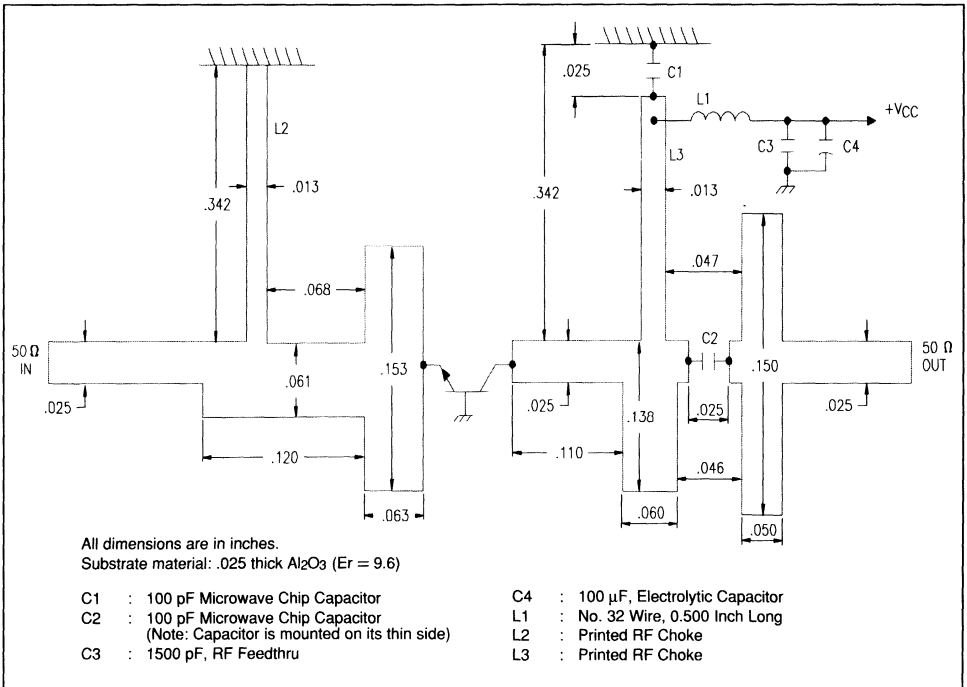
**TYPICAL COLLECTOR LOAD IMPEDANCES**



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	11.5 + j 14.0	22.5 + j 5.5
• = 2.9 GHz	11.5 + j 12.5	19.5 + j 5.0
M = 3.1 GHz	10.0 + j 15.5	14.5 + j 2.0
• = 3.3 GHz	11.0 + j 19.0	14.5 - j 2.0
H = 3.5 GHz	11.0 + j 20.5	17.5 - j 3.5

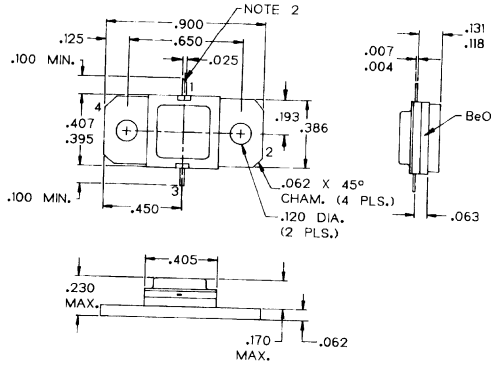


**TEST CIRCUIT**



PACKAGE MECHANICAL DATA

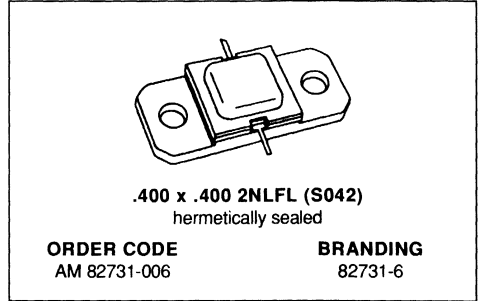
Ref.: Dwg. No.: J113214F



- NOTES:  
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.  
2. COLLECTOR LEAD SLANT CUT.

**RF & MICROWAVE TRANSISTORS  
S-BAND RADAR APPLICATIONS**

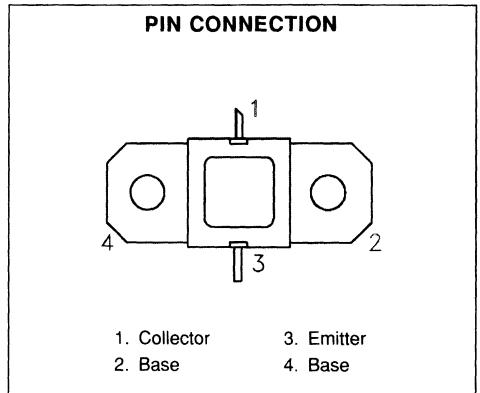
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT IMPEDANCE MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 5.5 W. MIN. WITH 5.6 dB GAIN
- BANDWIDTH = 400 MHz


**DESCRIPTION**

The AM82731-006 device is a medium power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and can withstand a 5:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency.

The AM82731-006 is supplied in the hermetic metal/ceramic package with internal input/output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 100°C)	40	W
I <sub>c</sub>	Device Current*	1.8	A
V <sub>CC</sub>	Collector-Supply Voltage*	34	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	3.75	°C/W
----------------------	----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	50	—	—	V
$I_{CES}$	$V_{CE} = 30V$		—	—	4	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	10	—	—	—

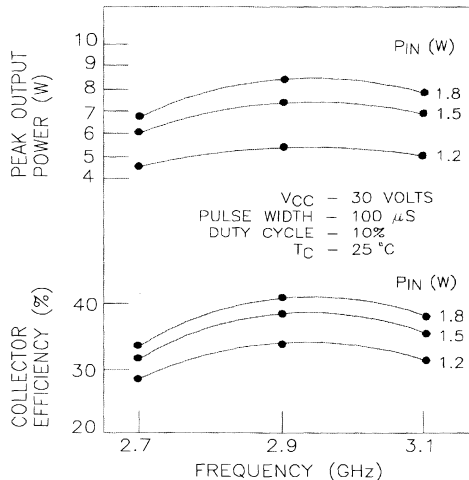
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.7 - 3.1GHz$	$P_{IN} = 1.5W$	$V_{CC} = 30V$	5.5	6.0	—	W
$\eta_C$	$f = 2.7 - 3.1GHz$	$P_{IN} = 1.5W$	$V_{CC} = 30V$	27	32	—	%
$G_{PB}$	$f = 2.7 - 3.1GHz$	$P_{IN} = 1.5W$	$V_{CC} = 30V$	5.6	6.0	—	dB

Note: Pulse Width = 100 $\mu$ S  
 Duty Cycle = 10%

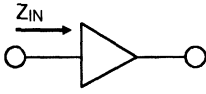
**TYPICAL PERFORMANCE**

**TYPICAL BROADBAND PERFORMANCE**

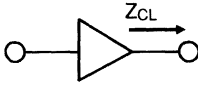


**IMPEDANCE DATA**

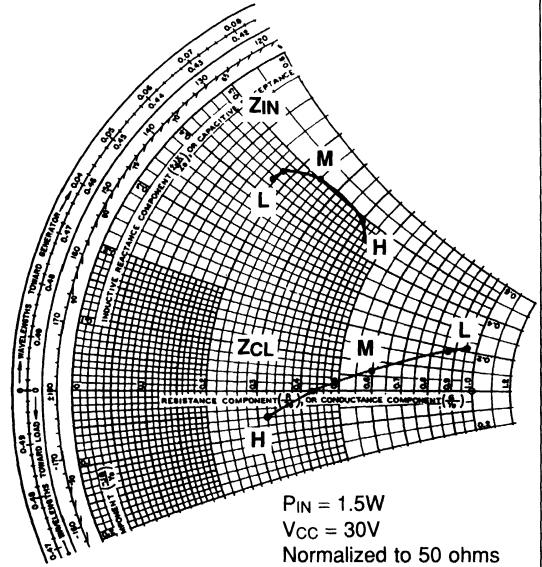
**TYPICAL INPUT IMPEDANCES**



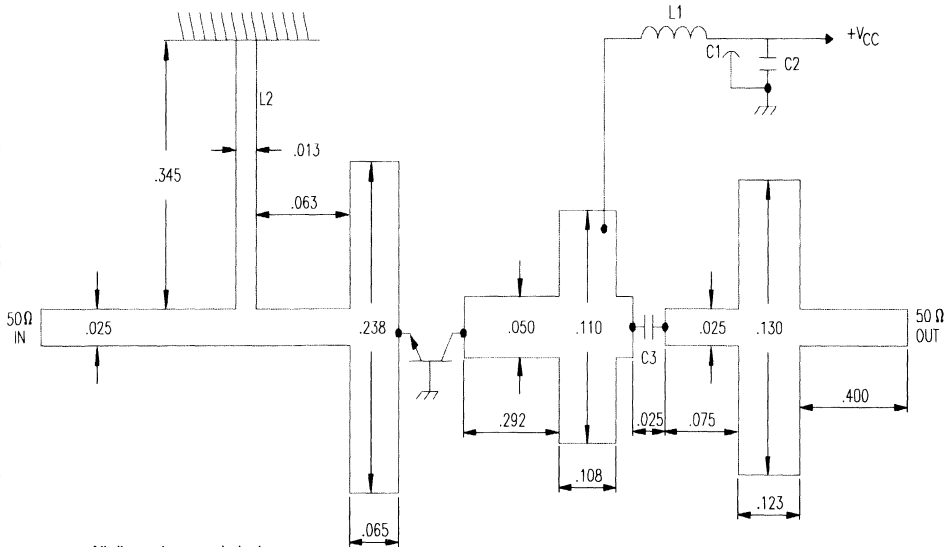
**TYPICAL COLLECTOR LOAD IMPEDANCES**



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	9.0 + j 22.0	48.0 + j 11.5
• = 2.9 GHz	9.0 + j 23.0	43.0 + j 9.0
M = 3.1 GHz	12.5 + j 25.0	30.0 + j 3.0
• = 3.3 GHz	20.0 + j 25.0	21.5 + j 0.0
H = 3.5 GHz	22.0 + j 22.5	16.0 - j 3.0



**TEST CIRCUIT**



All dimensions are in inches.  
Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub> (Er = 9.6)

- C1 : 1500 pF RF Feedthru
- C2 : 100 μF Electrolytic

- C3 : 100 pF Chip Capacitor
- L1 : No. 32 Wire, 0.062 Inch Long
- L2 : Printed RF Choke

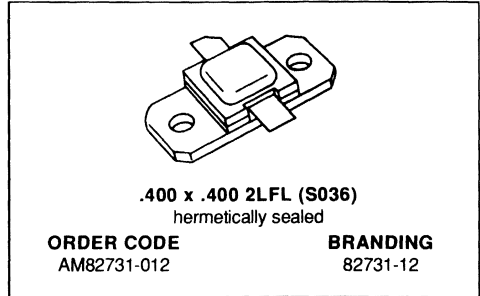




## RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 12$  W MIN. WITH 6.0 dB GAIN

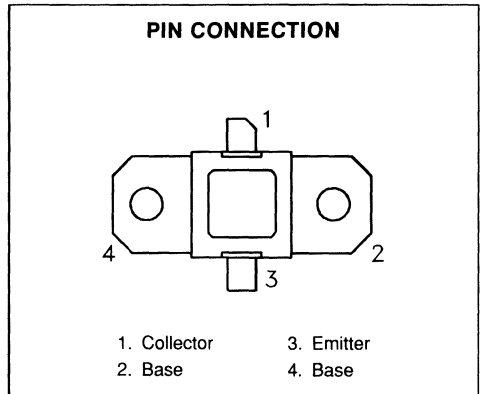


### DESCRIPTION

The AM82731-012 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and can withstand a 3:1 output VSWR with a + 1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM82731-012 is supplied in the Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	50	W
$I_c$	Device Current*	2.0	A
$V_{CC}$	Collector-Supply Voltage*	46	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	4.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

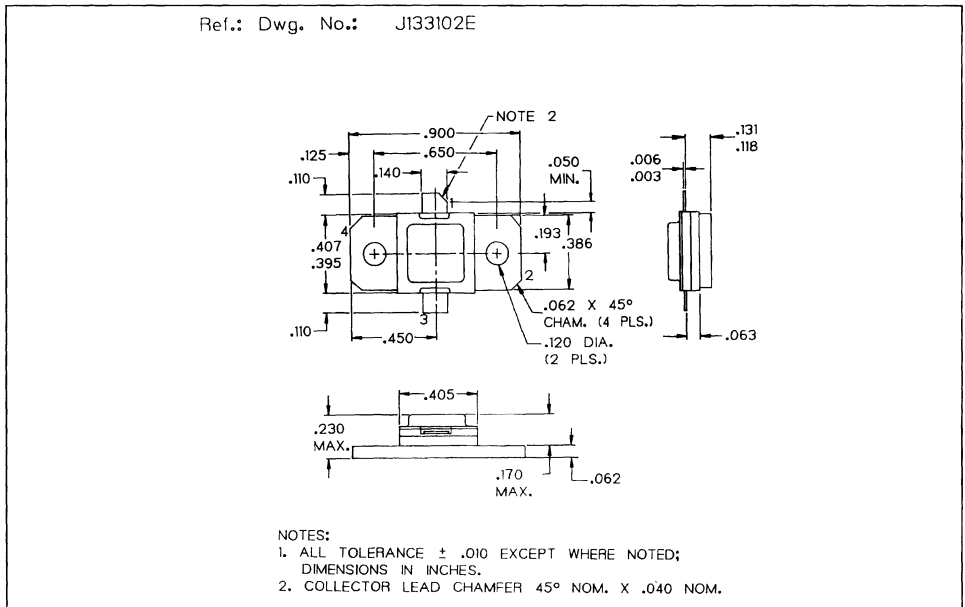
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 7mA	I <sub>E</sub> = 0mA	55	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 7mA	R <sub>BE</sub> = 10Ω	55	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 40V		—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = V	I <sub>C</sub> = 600mA	30	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2700 —3100 MHz	P <sub>IN</sub> = 3.0W	V <sub>CC</sub> = 40V	12	—	—	W
η <sub>c</sub>	f = 2700 —3100 MHz	P <sub>IN</sub> = 3.0W	V <sub>CC</sub> = 40V	30	—	—	%
G <sub>p</sub>	f = 2700 —3100 MHz	P <sub>IN</sub> = 3.0W	V <sub>CC</sub> = 40V	6.0	—	—	dB

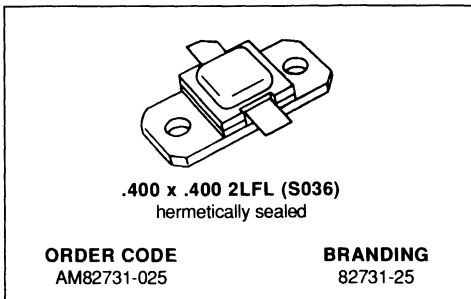
Note: Pulse Width = 100μS  
 Duty Cycle = 10%

PACKAGE MECHANICAL DATA



## RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

- LOW PARASITIC, DOUBLE LEVEL MET-AL DESIGN
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR @ 1 dB OVERDRIVE
- LOW RF THERMAL RESISTANCE
- INPUT/OUTPUT IMPEDANCE MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 25$  W MIN. WITH 6.2 dB GAIN

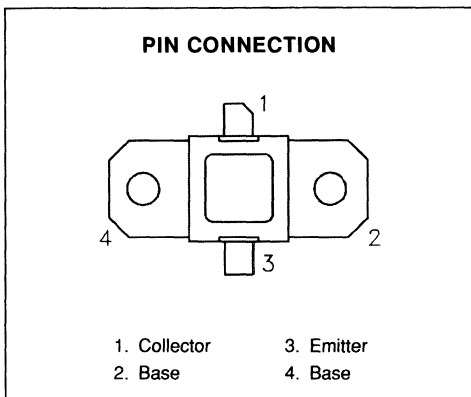


### DESCRIPTION

The AM82731-025 device is a high power silicon bi-polar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles, and temperatures and can withstand a 3:1 output VSWR with a +1dB input over drive. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM82731-025 is supplied in the Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	100	W
$I_C$	Device Current*	4	A
$V_{CC}$	Collector-Supply Voltage*	46	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

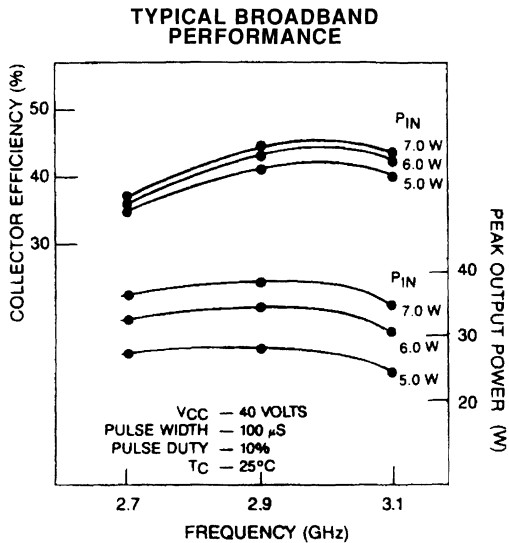
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 15mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 15mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{CE} = 0V$	$V_{BE} = 40V$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1.5A$	30	—	—	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.7 - 3.1GHz$	$P_{IN} = 6.0W$	$V_{CC} = 40V$	25	30	—	W
$\eta_c$	$f = 2.7 - 3.1GHz$	$P_{IN} = 6.0W$	$V_{CC} = 40V$	30	36	—	%
GPB	$f = 2.7 - 3.1GHz$	$P_{IN} = 6.0W$	$V_{CC} = 40V$	6.2	7.0	—	dB

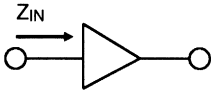
Note: Pulse Width = 100  $\mu$ Sec  
 Duty Cycle = 10%

**TYPICAL PERFORMANCE**

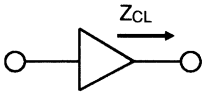


IMPEDANCE DATA

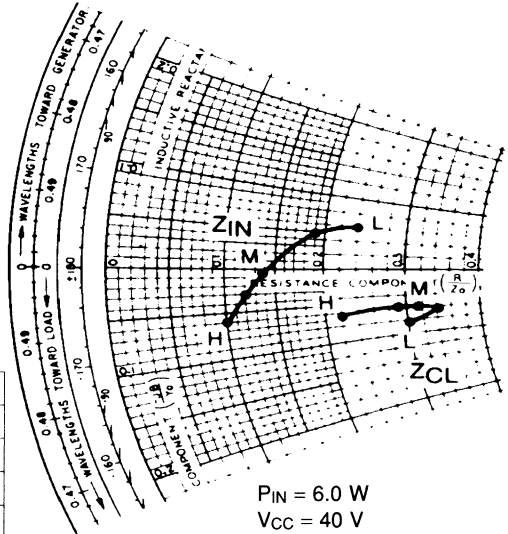
TYPICAL INPUT IMPEDANCES



TYPICAL COLLECTOR LOAD IMPEDANCES

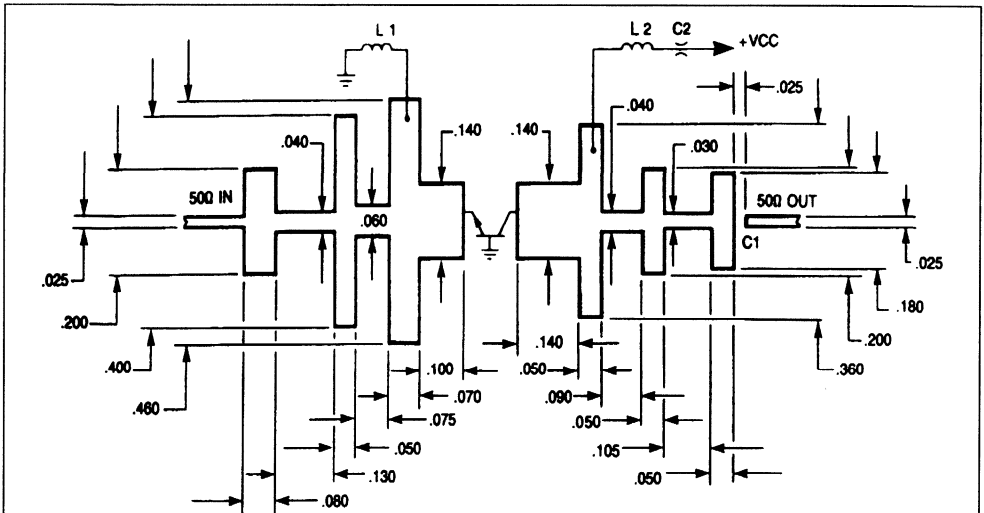


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	12.0 + j 3.0	15.0 - j 4.0
• = 2.8 GHz	9.5 + j 2.5	17.0 - j 3.0
M = 2.9 GHz	6.5 + j 0.0	15.5 - j 3.0
• = 3.0 GHz	6.0 - j 1.5	14.5 - j 3.0
H = 3.1 GHz	5.0 - j 3.0	11.0 - j 3.0



P<sub>IN</sub> = 6.0 W  
 V<sub>CC</sub> = 40 V  
 Normalized to 50 ohms

TEST CIRCUIT

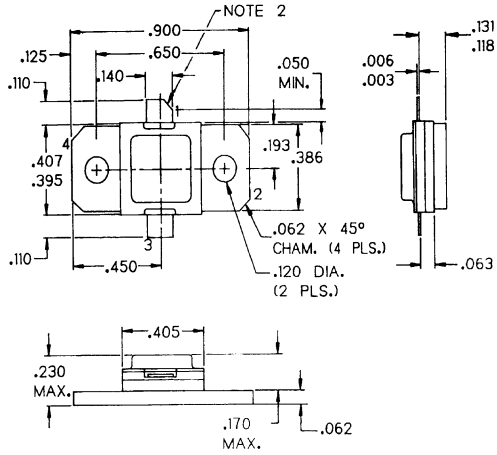


All dimensions are in inches.  
 Substrate material: .025 thick Al<sub>2</sub>O<sub>3</sub> (Er = 9.6)

- C1 : 22 pF Chip Capacitor
- C2 : 1500 pF RF Feedthrough
- L1 : No. 26 Wire, 2 Turn, 0.08 Inch I.D.
- L2 : No. 26 Wire, 2 Turn, 0.08 Inch I.D.

PACKAGE MECHANICAL DATA

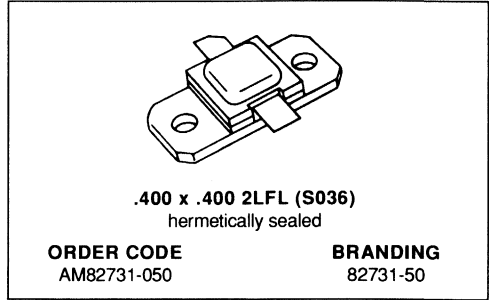
Ref.: Dwg. No.: J133102E



- NOTES:
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
  2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

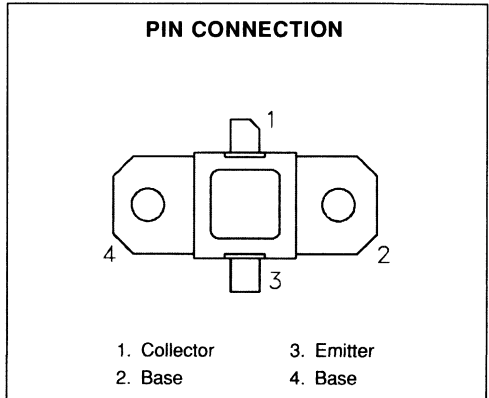
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- RUGGEDIZED VSWR 3:1 @ 1 dB OVER-DRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 50 W MIN. WITH 6 dB GAIN


**DESCRIPTION**

The AM82731-050 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

The device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM82731-050 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 50°C)	167	W
I <sub>C</sub>	Device Current*	8	A
V <sub>CC</sub>	Collector-Supply Voltage*	46	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	1.2	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{CE} = 40V$		—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	30	—	—	—

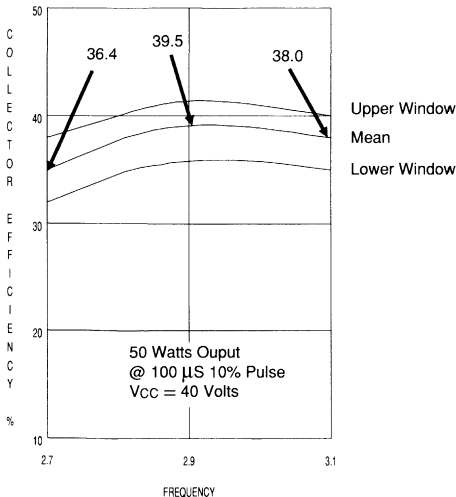
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2700 - 3100MHz$	$P_{IN} = 12.5W$	$V_{CC} = 40V$	50	56	—	W
$\eta_C$	$f = 2700 - 3100MHz$	$P_{IN} = 12.5W$	$V_{CC} = 40V$	30	35	—	%
$G_P$	$f = 2700 - 3100MHz$	$P_{IN} = 12.5W$	$V_{CC} = 40V$	6.0	6.5	—	dB

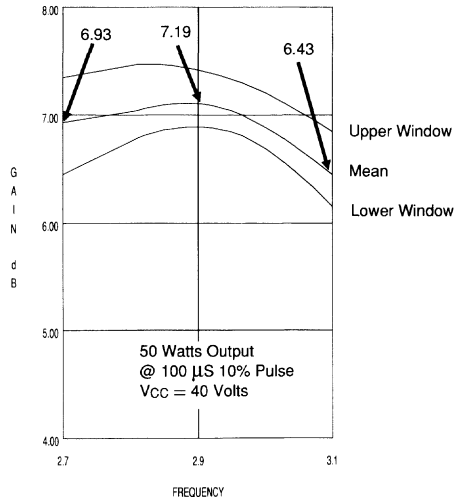
Note: Pulse Width = 100µS  
Duty Cycle = 10%

**TYPICAL PERFORMANCE**

**COLLECTOR EFFICIENCY vs FREQUENCY**



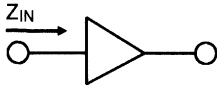
**GAIN vs FREQUENCY**



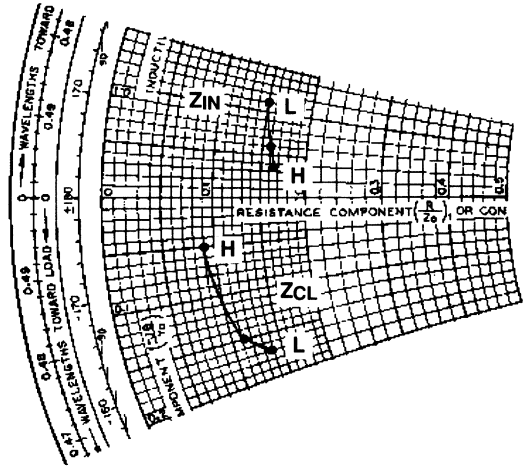
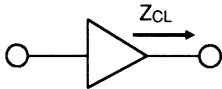


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



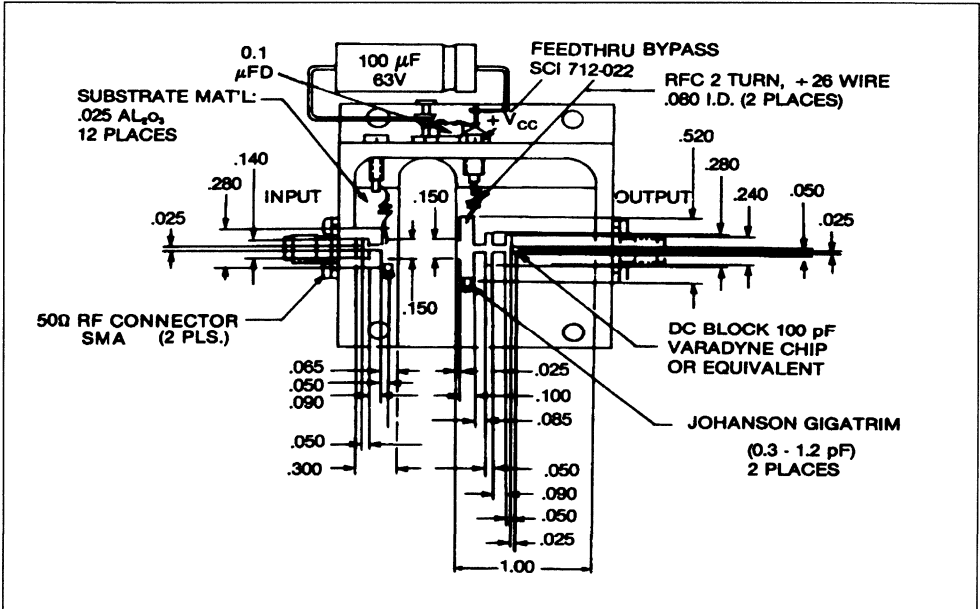
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	7.4 + j 5.4	7.1 - j 8.6
M = 2.9 GHz	7.8 + j 3.0	5.4 - j 7.4
H = 3.1 GHz	8.0 + j 2.0	4.6 - j 2.6

P<sub>IN</sub> = 12.5 W  
 V<sub>CC</sub> = 40 V  
 Z<sub>0</sub> = 50 ohms

TEST CIRCUIT





**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

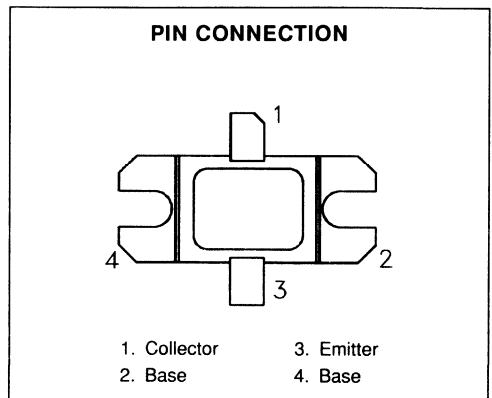
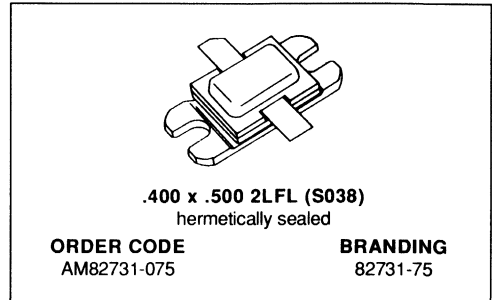
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 75$  W MIN. WITH 7.0 dB GAIN

**DESCRIPTION**

The AM82731-075 device is a high power silicon bipolar NPN transistor specifically designed for medium pulse S-Band radar output and driver applications.

This device is characterized at 100  $\mu$ sec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures, and can withstand 3:1 output VSWR with a + 1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM82731-075 is supplied in the BIGPAC™ hermetic metal/ceramic package with internal input/output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 75^{\circ}C$ )	290	W
$I_c$	Device Current*	10	A
$V_{CC}$	Collector-Supply Voltage*	45	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.6	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

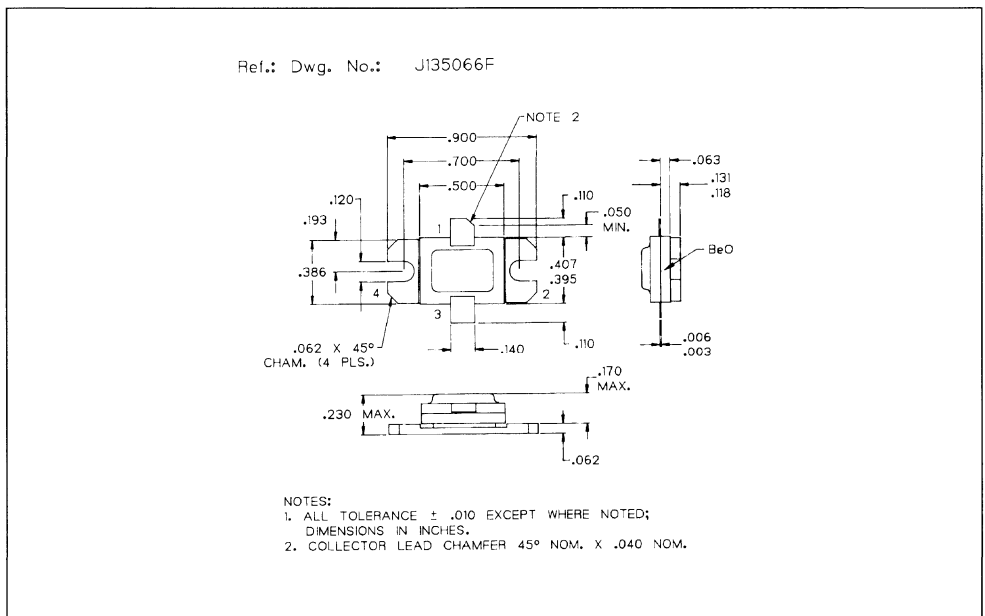
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 40V$	—	—	40	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	30	—	300	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2700 - 3100MHz$	$P_{IN} = 15W$	$V_{CC} = 40V$	75	—	—	W
$\eta_C$	$f = 2700 - 3100MHz$	$P_{IN} = 15W$	$V_{CC} = 40V$	35	—	—	%
$G_P$	$f = 2700 - 3100MHz$	$P_{IN} = 15W$	$V_{CC} = 40V$	7.0	—	—	dB

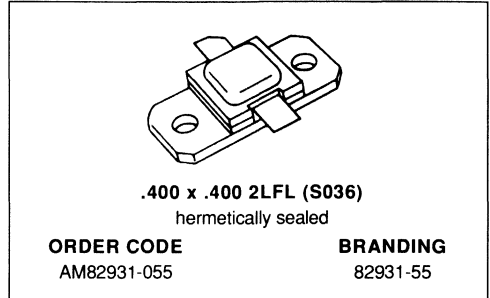
Note: Pulse Width = 100 $\mu$ Sec  
 Duty Cycle = 10%

**PACKAGE MECHANICAL DATA**



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

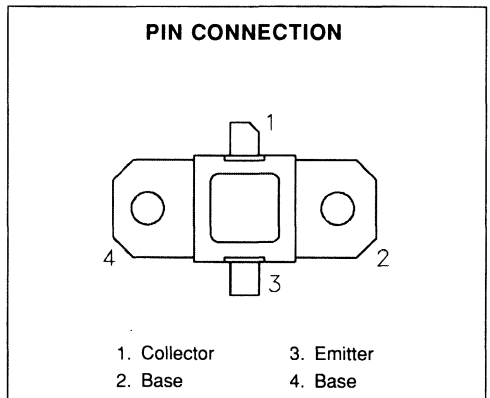
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY @ 1dB OVERDRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 55$  W MIN. WITH 6.1 dB GAIN
- BANDWIDTH = 200 MHz


**DESCRIPTION**

The AM82931-055 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 3:1 output VSWR with a +1dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM82931-055 is supplied in the AMPACT™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	300	W
$I_C$	Device Current*	8	A
$V_{CC}$	Collector-Supply Voltage*	48	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.50	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

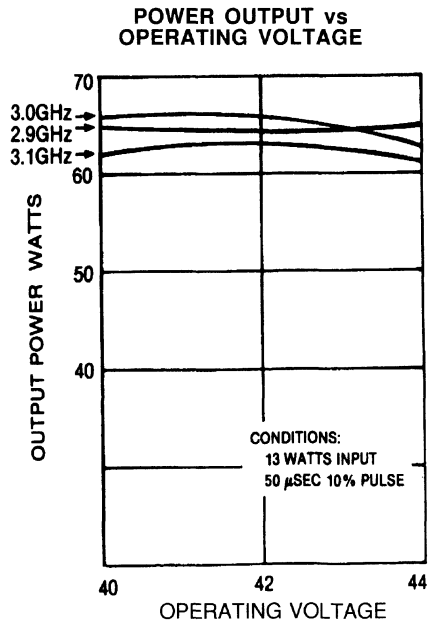
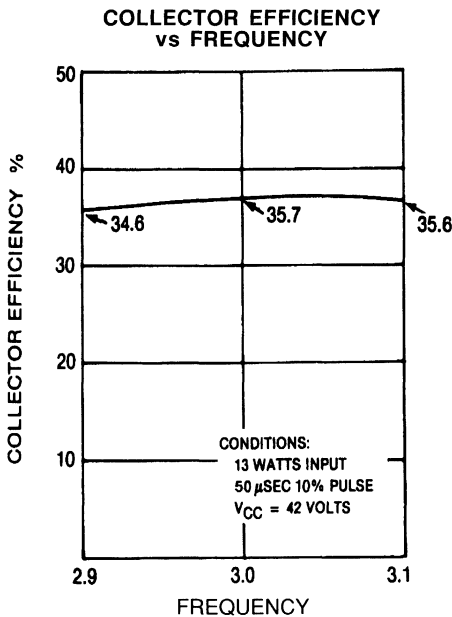
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{CE} = 42V$		—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	30	—	—	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.9 - 3.1GHz$	$P_{IN} = 3.5W$	$V_{CC} = 42V$	55	63	—	W
$\eta_C$	$f = 2.9 - 3.1GHz$	$P_{IN} = 3.5W$	$V_{CC} = 42V$	32	35	—	%
$G_p$	$f = 2.9 - 3.1GHz$	$P_{IN} = 3.5W$	$V_{CC} = 42V$	6.1	6.5	—	dB

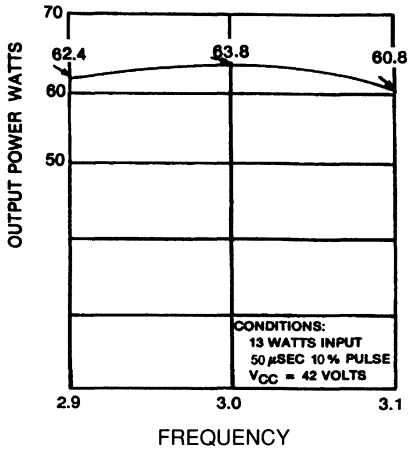
Note: Pulse Width =  $50\mu Sec$   
 Duty Cycle = 10%

**TYPICAL PERFORMANCE**

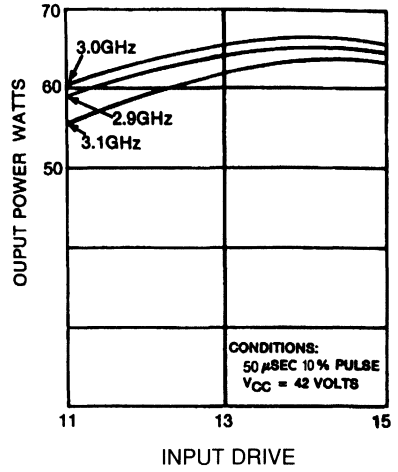


TYPICAL PERFORMANCE

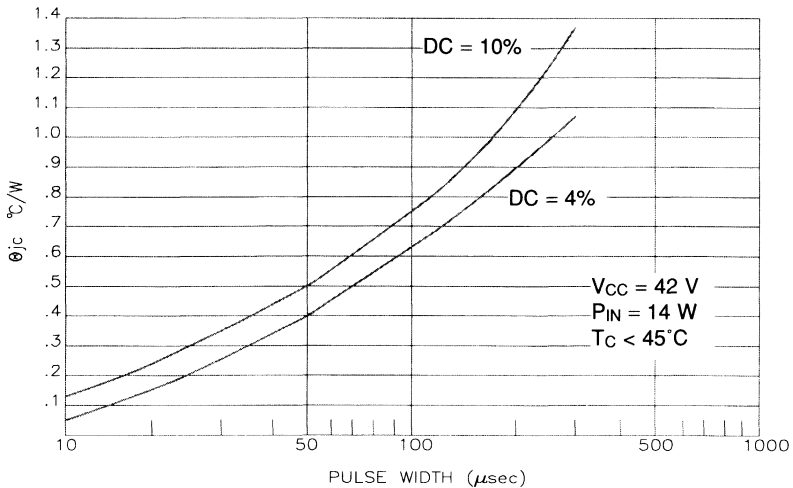
POWER OUTPUT vs FREQUENCY



POWER OUTPUT vs INPUT DRIVE

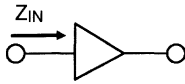


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

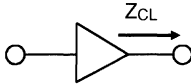


IMPEDANCE DATA

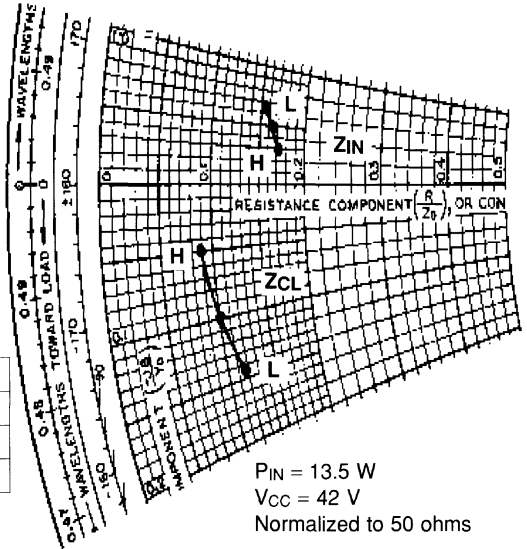
TYPICAL INPUT  
IMPEDANCE



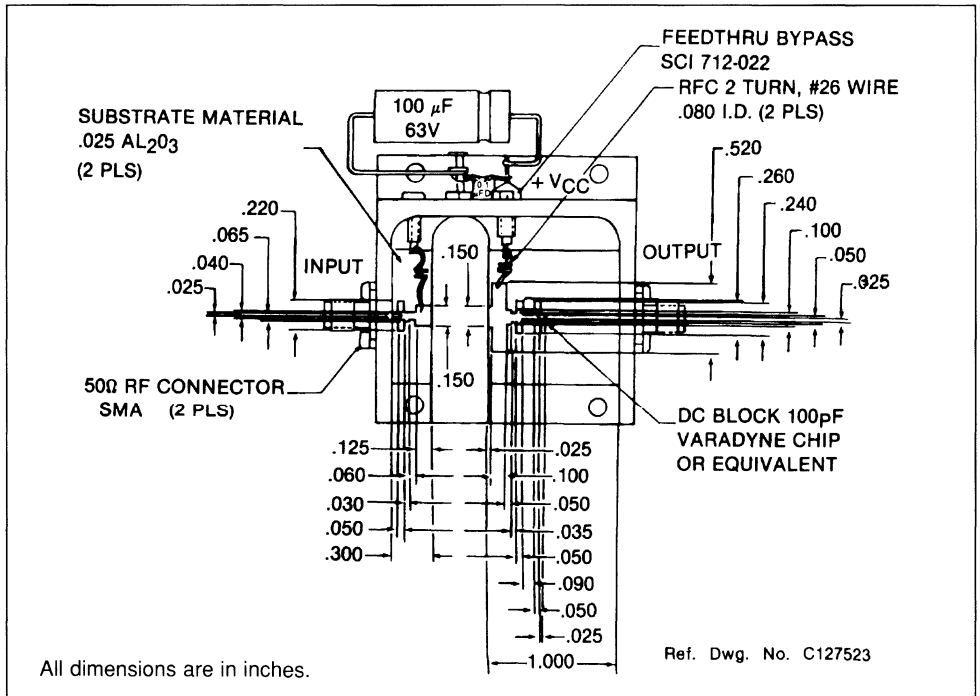
TYPICAL COLLECTOR  
LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.9 GHz	8.30 + j 3.0	5.7 - j 7.2
M = 3.0 GHz	8.3 + j 2.3	5.2 - j 5.0
H = 3.1 GHz	8.6 + j 1.6	4.6 - j 2.6



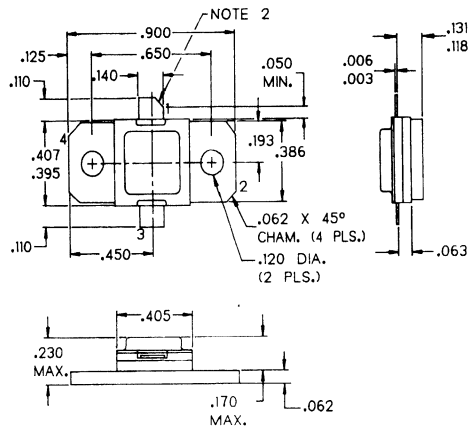
TEST CIRCUIT





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J133102E



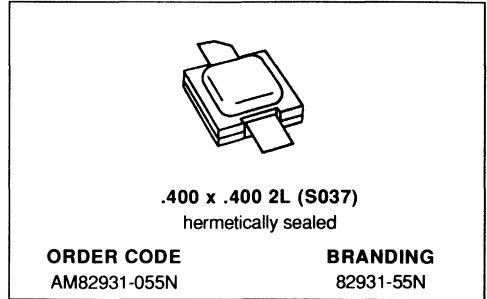
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



## RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY @ 1dB OVERDRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 55 W MIN. WITH 6.1 dB GAIN
- BANDWIDTH = 200 MHz

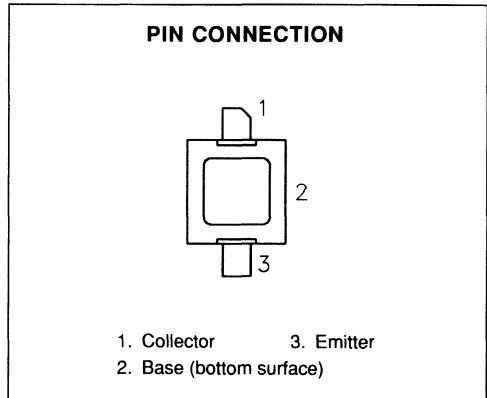


### DESCRIPTION

The AM82931-055N device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 3:1 output VSWR with a +1dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM82931-055N is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	300	W
I <sub>C</sub>	Device Current*	8	A
V <sub>CC</sub>	Collector-Supply Voltage*	48	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.50	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{CE} = 42V$		—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	30	—	—	—

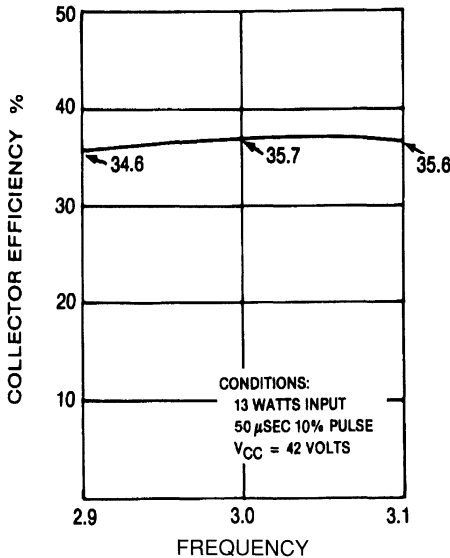
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.9 - 3.1GHz$	$P_{IN} = 13.5W$	$V_{CC} = 42V$	55	63	—	W
$\eta_C$	$f = 2.9 - 3.1GHz$	$P_{IN} = 13.5W$	$V_{CC} = 42V$	32	35	—	%
$G_P$	$f = 2.9 - 3.1GHz$	$P_{IN} = 13.5W$	$V_{CC} = 42V$	6.1	6.5	—	dB

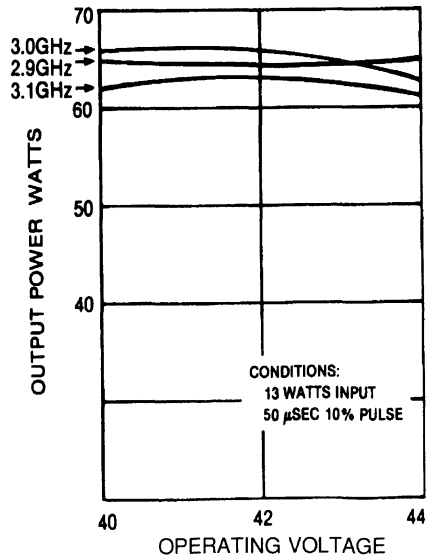
Note: Pulse Width =  $50\mu Sec$   
 Duty Cycle = 10%

**TYPICAL PERFORMANCE**

**COLLECTOR EFFICIENCY vs FREQUENCY**

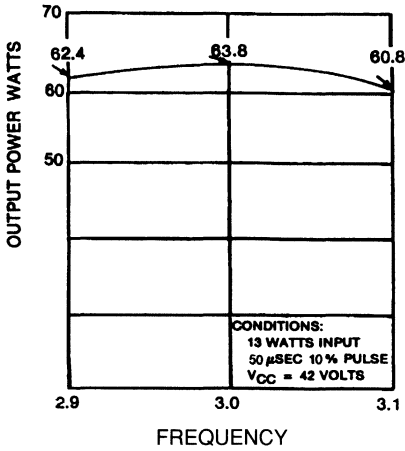


**POWER OUTPUT vs OPERATING VOLTAGE**

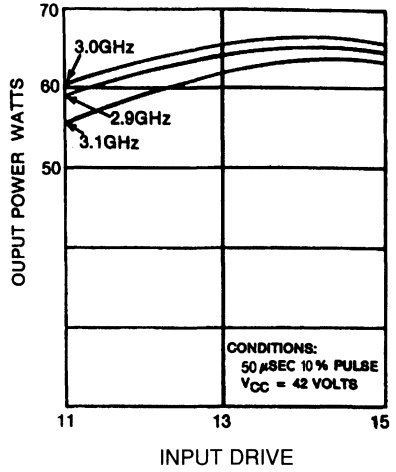


TYPICAL PERFORMANCE

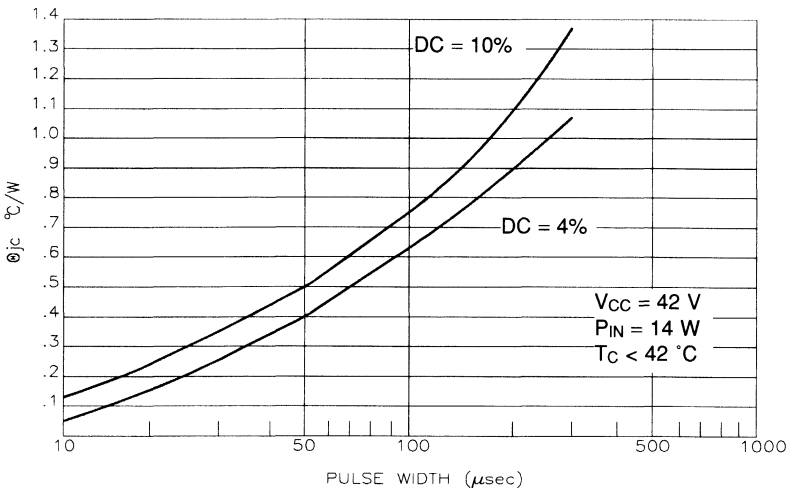
OUTPUT POWER vs FREQUENCY



OUTPUT POWER vs INPUT DRIVE

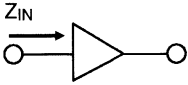


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

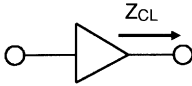


IMPEDANCE DATA

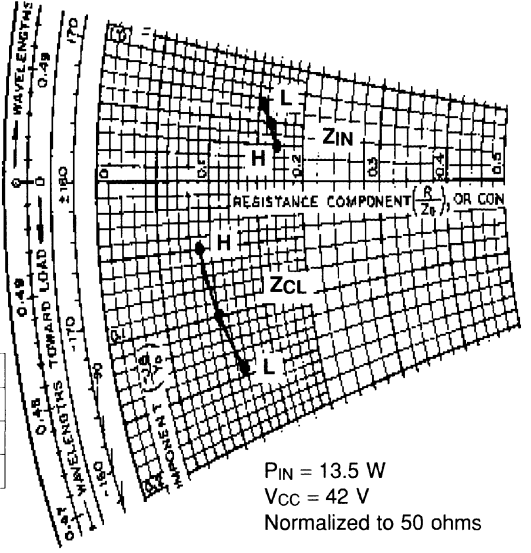
TYPICAL INPUT IMPEDANCE



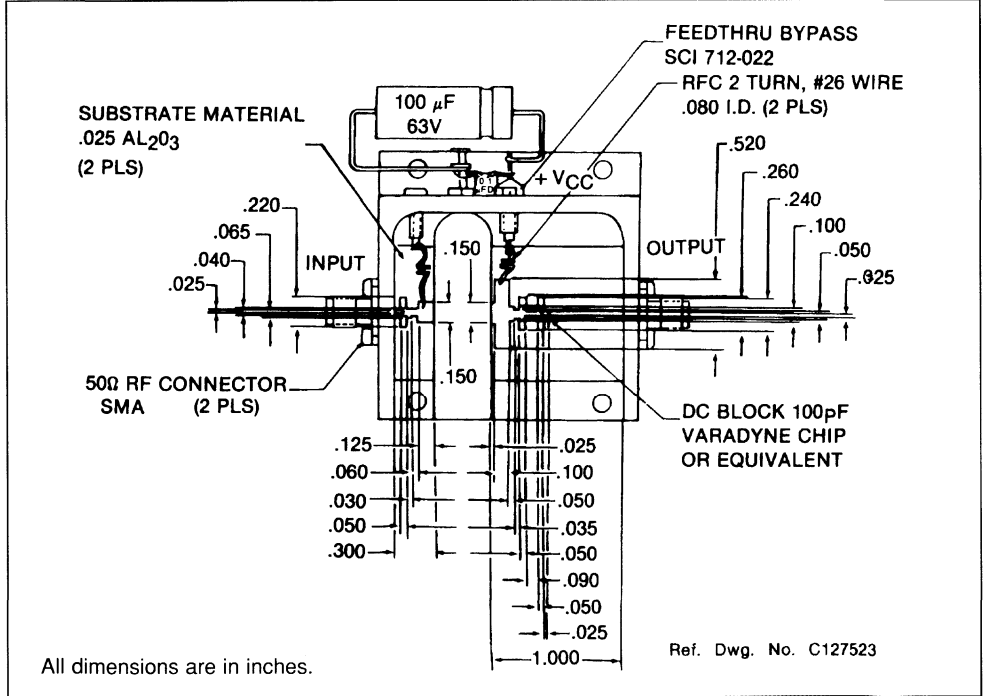
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.9 GHz	8.0 + j 3.0	5.7 - j 7.2
M = 3.0 GHz	8.3 + j 2.3	5.2 - j 5.0
H = 3.1 GHz	8.6 + j 1.6	4.6 - j 2.6

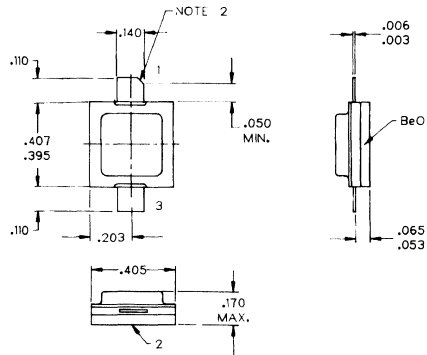


TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135085B



## NOTES:

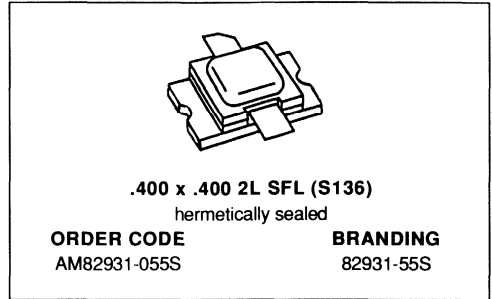
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER  $45^\circ$  NOM.  
X  $.040$  MIN.





## RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY @ 1dB OVERDRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 55 W MIN. WITH 6.1 dB GAIN
- BANDWIDTH = 200 MHz

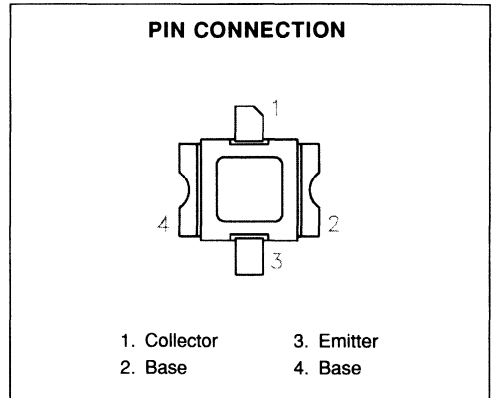


### DESCRIPTION

The AM82931-055S device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 3:1 output VSWR with a +1dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM82931-055S is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 100°C)	300	W
I <sub>c</sub>	Device Current*	8	A
V <sub>CC</sub>	Collector-Supply Voltage*	48	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.50	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{CE} = 42V$		—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	30	—	—	—

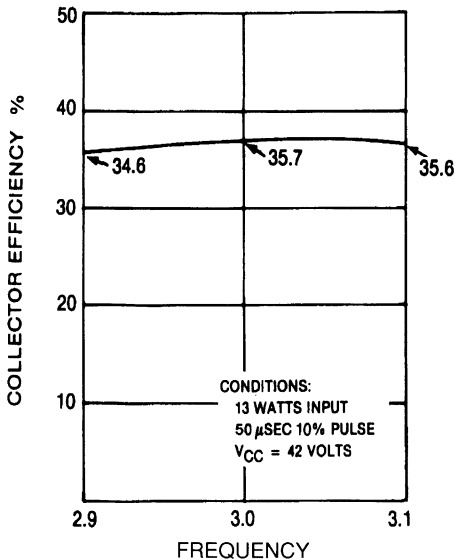
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.9 - 3.1GHz$	$P_{IN} = 13.5W$	$V_{CC} = 42V$	55	63	—	W
$\eta_c$	$f = 2.9 - 3.1GHz$	$P_{IN} = 13.5W$	$V_{CC} = 42V$	32	35	—	%
$G_P$	$f = 2.9 - 3.1GHz$	$P_{IN} = 13.5W$	$V_{CC} = 42V$	6.1	6.5	—	dB

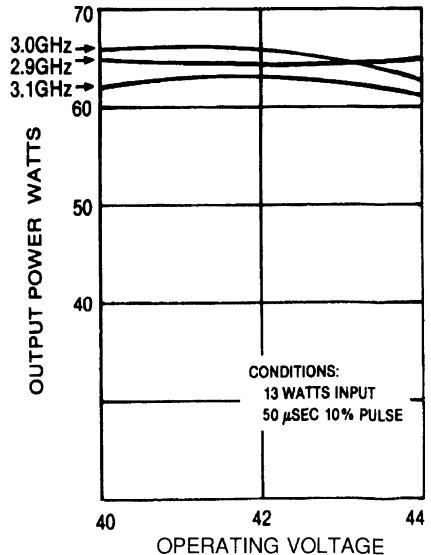
Note: Pulse Width = 50µSec  
 Duty Cycle = 10%

**TYPICAL PERFORMANCE**

**COLLECTOR EFFICIENCY vs FREQUENCY**

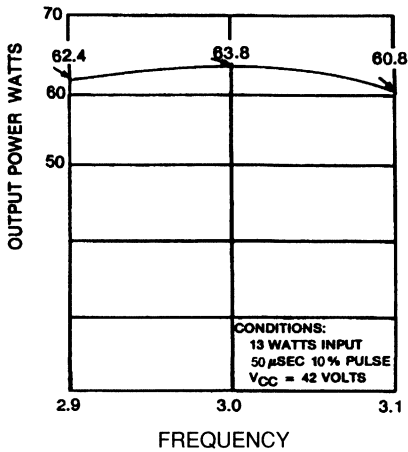


**OUTPUT POWER vs OPERATING VOLTAGE**

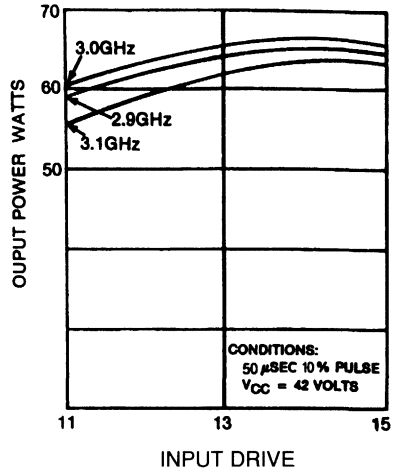


TYPICAL PERFORMANCE

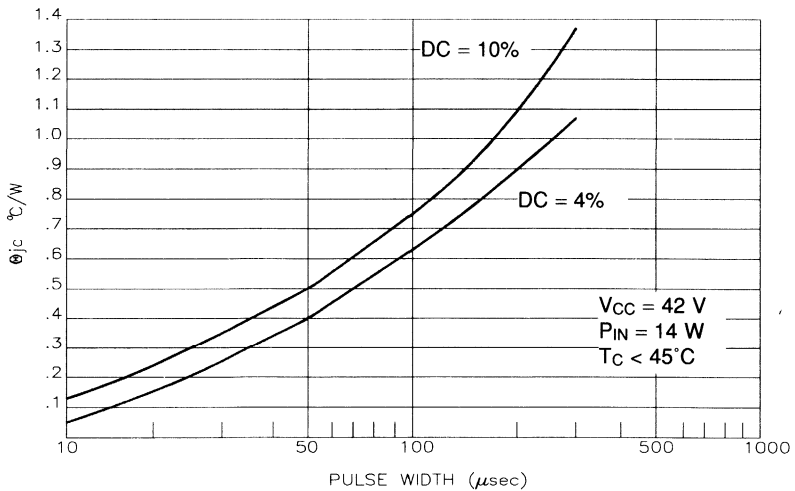
POWER OUTPUT vs FREQUENCY



POWER OUTPUT vs INPUT DRIVE

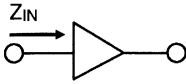


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

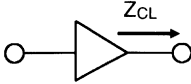


IMPEDANCE DATA

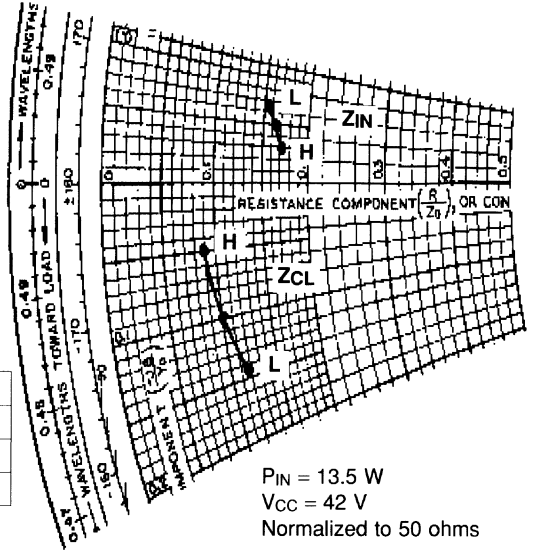
TYPICAL INPUT  
IMPEDANCE



TYPICAL COLLECTOR  
LOAD IMPEDANCE

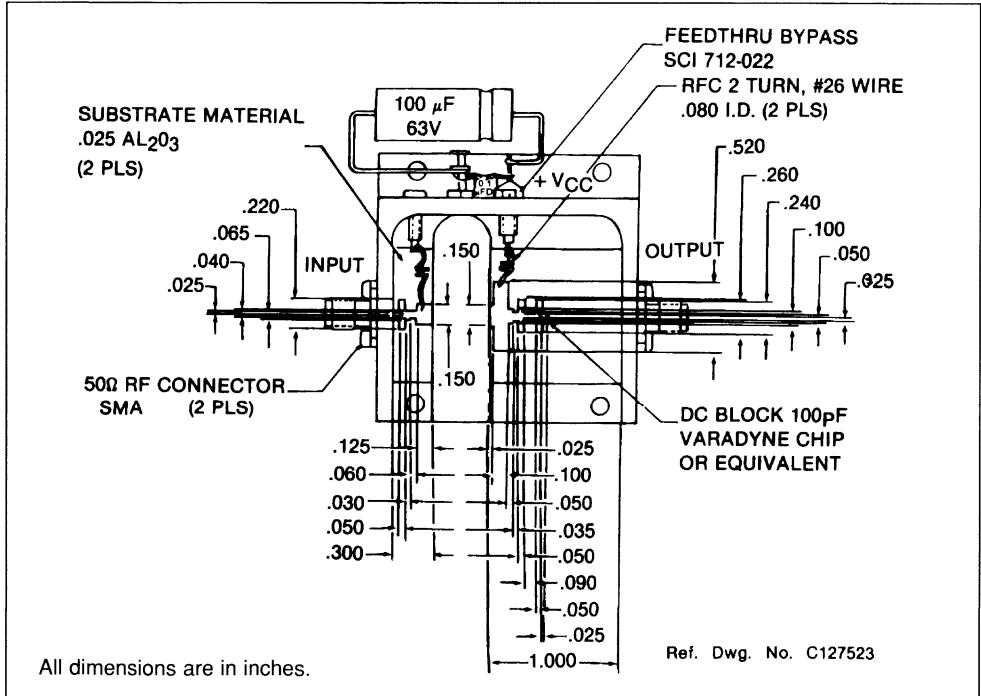


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.9 GHz	8.0 + j 3.0	5.7 - j 7.2
M = 3.0 GHz	8.3 + j 2.3	5.2 - j 5.0
H = 3.1 GHz	8.6 + j 1.6	4.6 - j 2.6



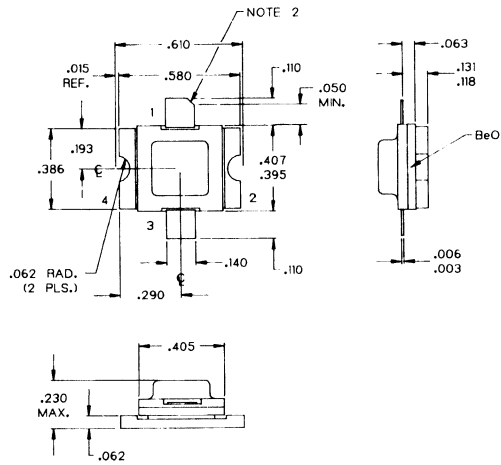
PIN = 13.5 W  
VCC = 42 V  
Normalized to 50 ohms

TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: JI35075B



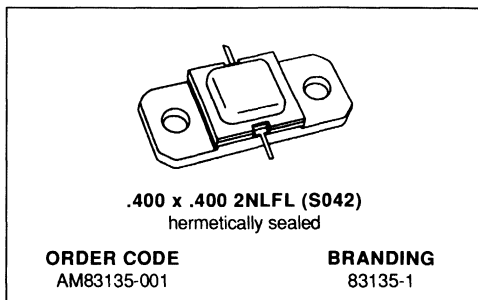
## NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER  $45^\circ$  NOM. X  $.040$  NOM.



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

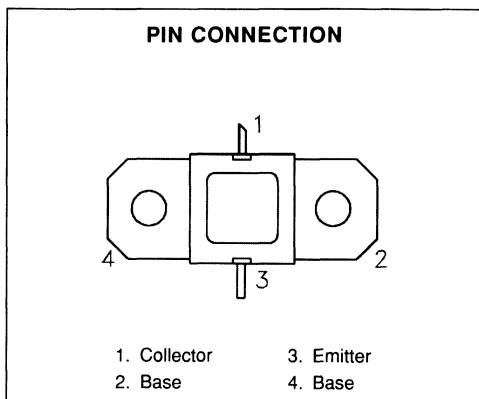
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 1.0$  W MIN. WITH 5.2 dB GAIN


**DESCRIPTION**

The AM83135-001 device is a medium power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 10:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency.

The AM83135-001 is supplied in the AMPAC™ Hermetic/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	11.5	W
$I_C$	Device Current*	0.45	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	13.0	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$	50	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 0.5\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$BV_{\text{CER}}$	$I_{\text{C}} = 1\text{mA}$	$R_{\text{BE}} = 10\Omega$	50	—	—	V
$I_{\text{CES}}$	$V_{\text{BE}} = 0\text{V}$	$V_{\text{CE}} = 30\text{V}$	—	—	0.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$	10	—	—	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 3.1 - 3.5\text{GHz}$	$P_{\text{IN}} = 0.3\text{W}$	$V_{\text{CC}} = 30\text{V}$	1.0	1.4	—	W
$\eta_{\text{c}}$	$f = 3.1 - 3.5\text{GHz}$	$P_{\text{IN}} = 0.3\text{W}$	$V_{\text{CC}} = 30\text{V}$	27	35	—	%
$G_{\text{P}}$	$f = 3.1 - 3.5\text{GHz}$	$P_{\text{IN}} = 0.3\text{W}$	$V_{\text{CC}} = 30\text{V}$	5.2	6.7	—	dB

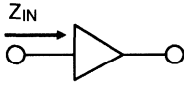
Note: Pulse Width = 100  $\mu\text{s}$ 

Duty Cycle = 10%

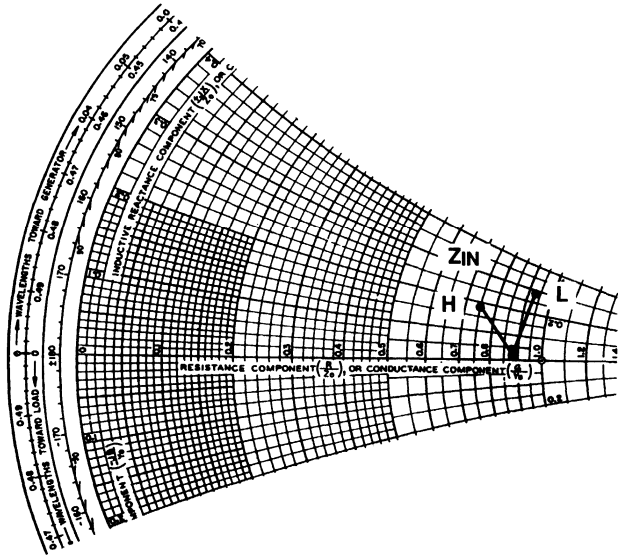


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

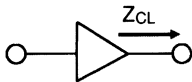


$P_{IN} = 0.3 \text{ W}$   
 $V_{CC} = 30 \text{ V}$   
 $Z_0 = 50 \text{ ohms}$

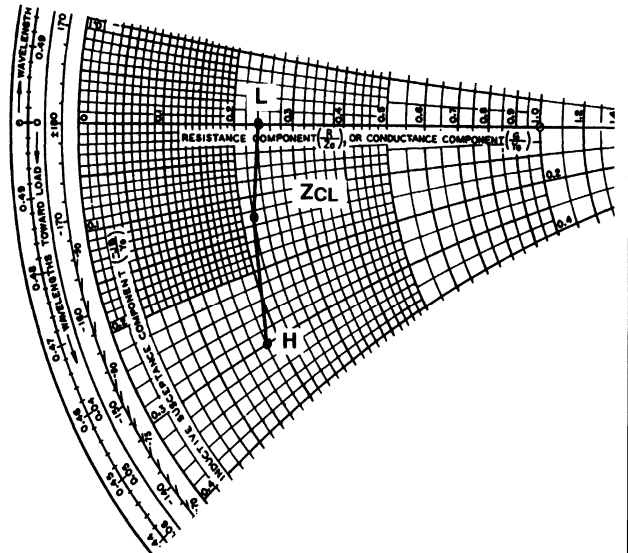


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 3.1 GHz	$46.0 + j 14.5$	$12.0 - j 0.0$
M = 3.3 GHz	$43.0 + j 10.0$	$11.0 - j 6.5$
H = 3.5 GHz	$38.0 + j 10.0$	$9.0 - j 15.0$

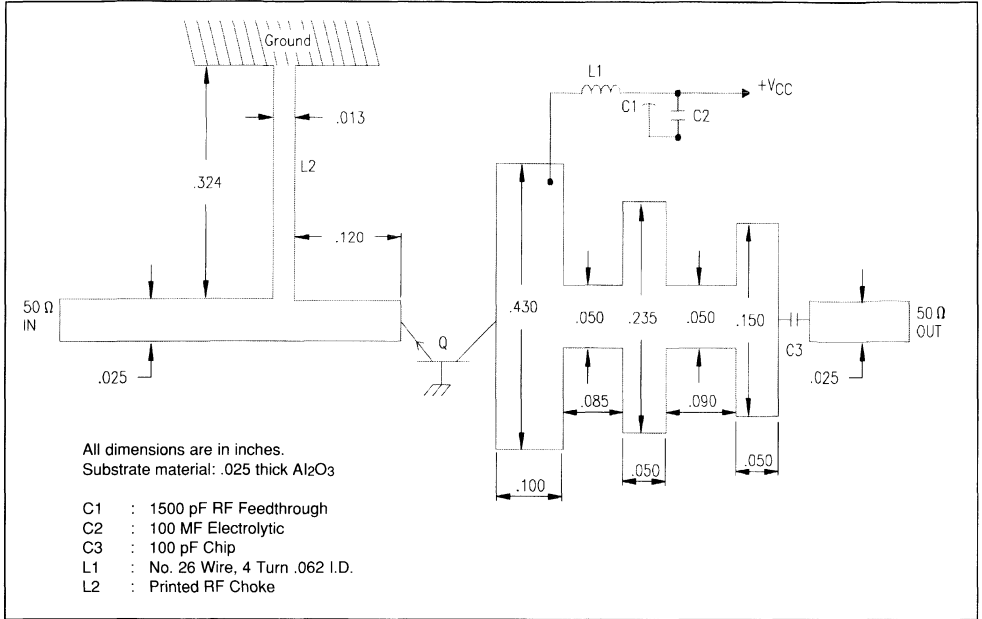
TYPICAL COLLECTOR LOAD IMPEDANCE



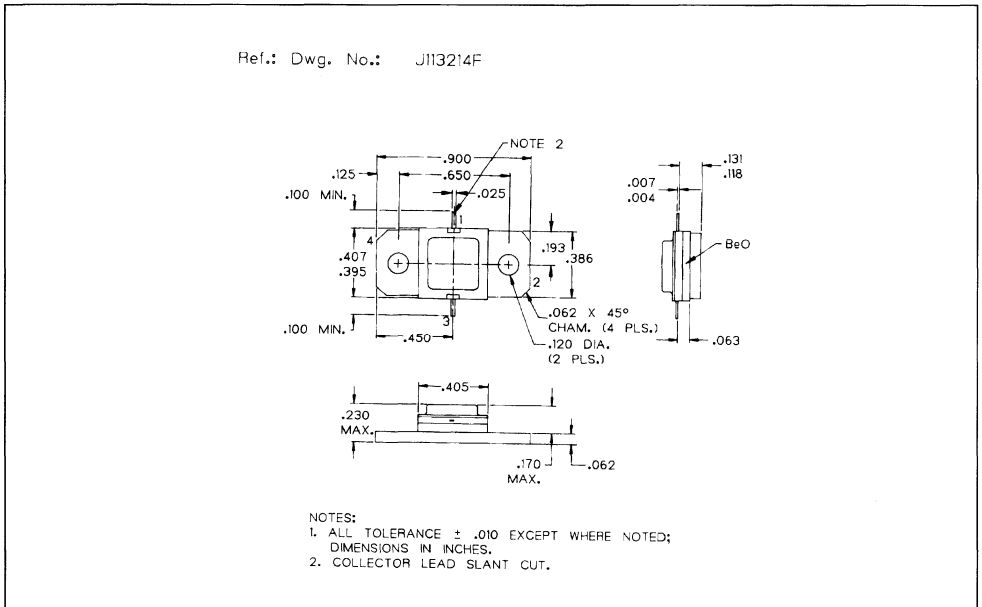
$P_{IN} = 0.3 \text{ W}$   
 $V_{CC} = 30 \text{ V}$   
 $Z_0 = 50 \text{ ohms}$



TEST CIRCUIT

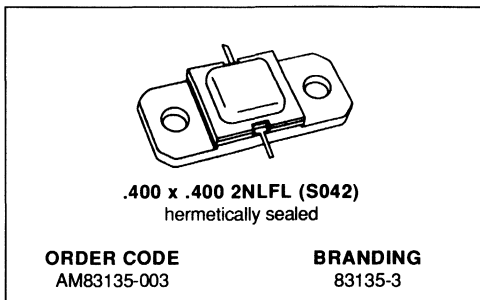


PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

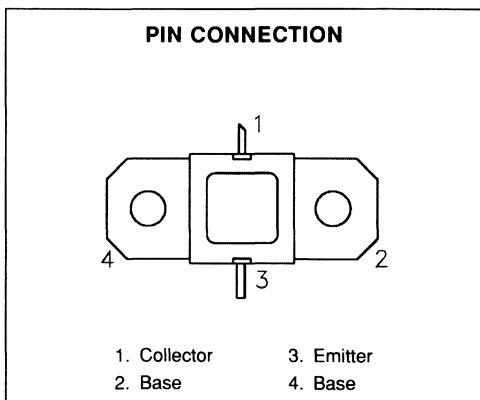
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 3.0 \text{ W MIN. WITH } 5.7 \text{ dB GAIN}$


**DESCRIPTION**

The AM83135-003 device is a medium power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 10:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency.

The AM83135-003 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}\text{C}$ )	23	W
$I_c$	Device Current*	0.9	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	6.5	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 2mA$	$I_E = 0mA$	45	—	—	V	
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V	
$BV_{CER}$	$I_C = 2mA$	$R_{BE} = 10\Omega$	45	—	—	V	
$I_{CES}$	$V_{CE} = 30V$		—	—	2.0	mA	
$h_{FE}$	$V_{CE} = 5V$	$I_C = 200mA$	10	—	—	—	

**DYNAMIC**

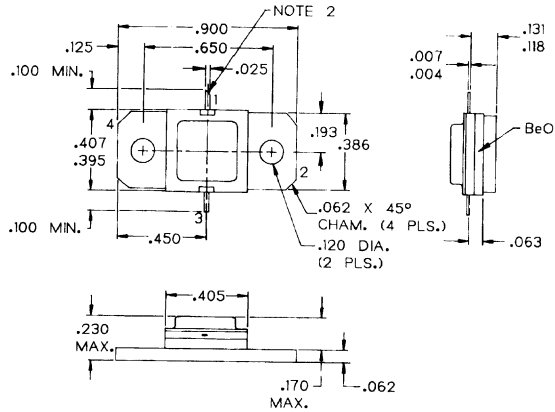
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.1 - 3.5GHz$	$P_{IN} = 0.8W$	$V_{CC} = 30V$	3.0	4.0	—	W
$\eta_C$	$f = 3.1 - 3.5GHz$	$P_{IN} = 0.8W$	$V_{CC} = 30V$	27	37	—	%
$G_P$	$f = 3.1 - 3.5GHz$	$P_{IN} = 0.8W$	$V_{CC} = 30V$	5.7	7.0	—	dB

Note: Pulse Width = 100  $\mu$ S  
 Duty Cycle = 10%



PACKAGE MECHANICAL DATA

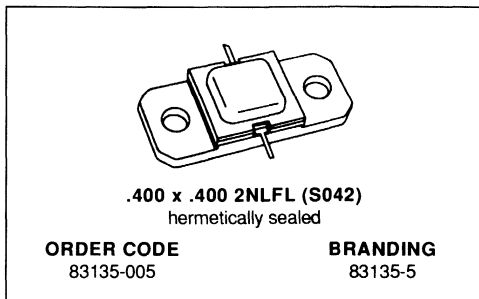
Ref.: Dwg. No.: J113214F  
Case Style: S042



- NOTES:  
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.  
2. COLLECTOR LEAD SLANT CUT.

**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

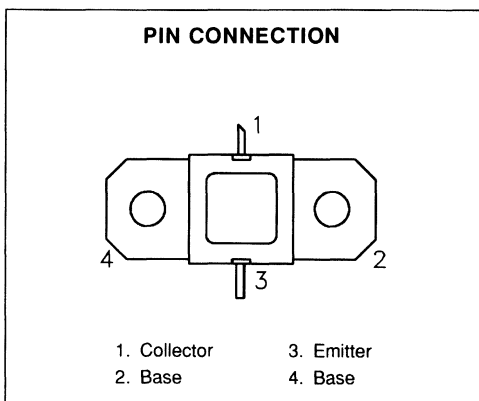
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 5.0$  W MIN. WITH 5.2 dB GAIN


**DESCRIPTION**

The AM83135-005 device is a medium power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures, and can withstand a 5:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM83135-005 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	40	W
$I_C$	Device Current*	1.8	A
$V_{CC}$	Collector-Supply Voltage*	34	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	3.75	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 4mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 4mA$	$R_{BE} = 10\Omega$	50	—	—	V
$I_{CES}$	$V_{CE} = 30V$		—	—	2.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	10	—	—	—

**DYNAMIC**

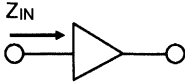
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.1 - 3.5GHz$	$P_{IN} = 1.5W$	$V_{CC} = 30V$	5.0	6.0	—	W
$\eta_C$	$f = 3.1 - 3.5GHz$	$P_{IN} = 1.5W$	$V_{CC} = 30V$	27	—	—	%
$G_P$	$f = 3.1 - 3.5GHz$	$P_{IN} = 1.5W$	$V_{CC} = 30V$	5.2	6.4	—	dB

Note: Pulse Width = 100 $\mu$ S  
 Duty Cycle = 10%

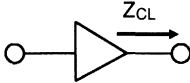


IMPEDANCE DATA

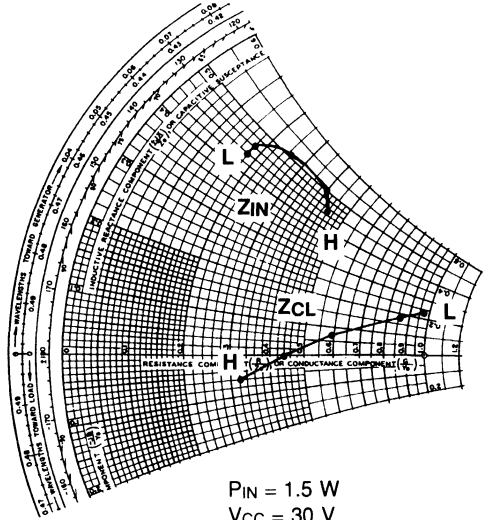
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

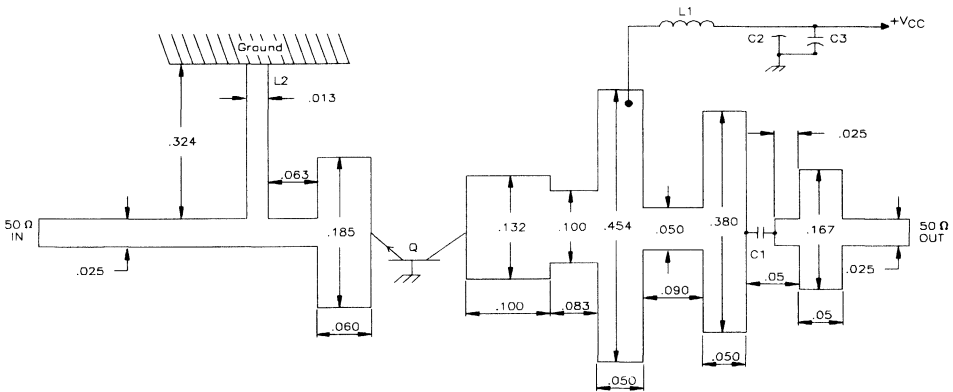


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.7 GHz	9.0 j 22.0	48.0 + j 11.5
• = 2.9 GHz	9.0 j 23.0	43.0 + j 9.0
M = 3.1 GHz	12.5 + j 25.0	30.0 + j 3.0
• = 3.3 GHz	20.0 + j 25.0	21.5 + 0.0
H = 3.5 GHz	22.0 + j 22.5	16.0 - j 3.0



P<sub>IN</sub> = 1.5 W  
 V<sub>CC</sub> = 30 V  
 Normalized to 50 ohms

TEST CIRCUIT



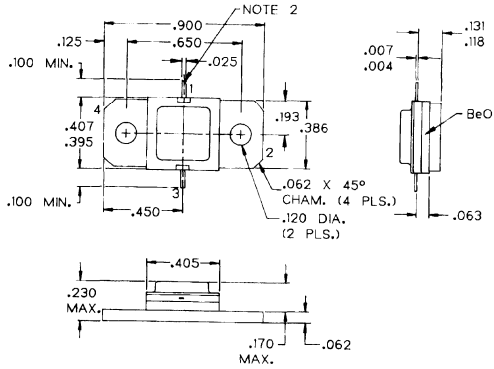
All dimensions are in inches.  
 Substrate Material: .025 tick Al<sub>2</sub>O<sub>3</sub> (Er = 9.6)

- C1 : 100 pF Chip Capacitor  
 (Note: Mounted on its thin side)
- C2 : 1500 pF RF Feedthru
- C3 : 100 mF Electrolytic

- L1 : No. 32 Wire, 2 Turns 1/16" I.D.
- L2 : Printed Choke

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F

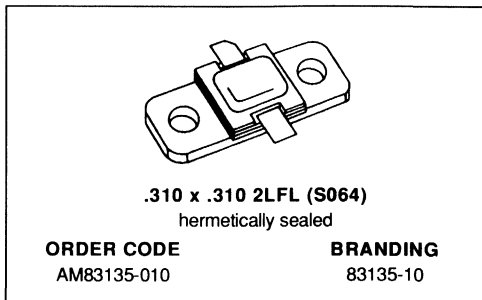


NOTES:

- 1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
- 2. COLLECTOR LEAD SLANT CUT.

**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

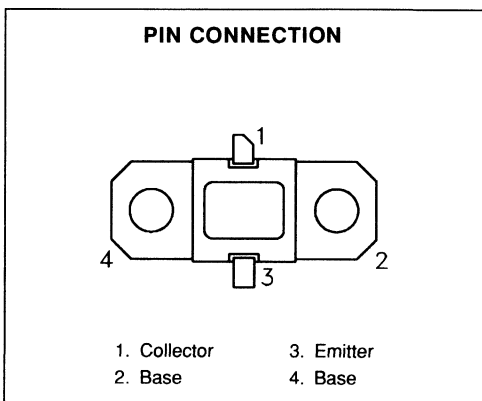
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 10$  W MIN. WITH 5.0 dB GAIN


**DESCRIPTION**

The AM83135-010 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is characterized at 100 $\mu$ sec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles, and temperatures, and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM83135-010 is supplied in the IMPAC™ hermetic metal/ceramic package with internal input/output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	50	W
$I_C$	Device Current*	2	A
$V_{CC}$	Collector-Supply Voltage*	46	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	4.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 7mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 7mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 40V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 600mA$	30	—	—	—

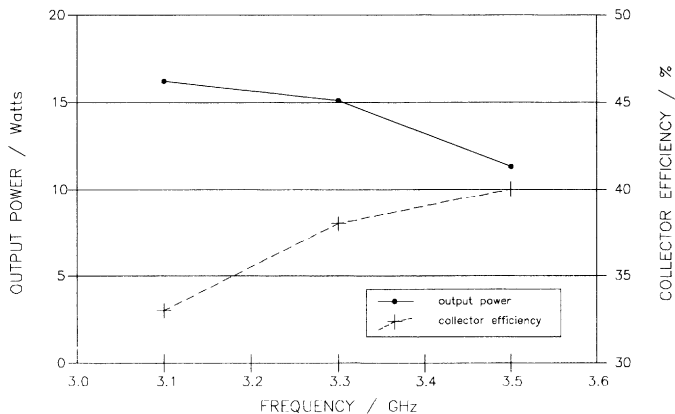
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.1 - 3.5GHz$	$P_{IN} = 3.2W$	$V_{CC} = 40V$	10	—	—	W
$\eta_C$	$f = 3.1 - 3.5GHz$	$P_{IN} = 3.2W$	$V_{CC} = 40V$	30	—	—	%
$G_P$	$f = 3.1 - 3.5GHz$	$P_{IN} = 3.2W$	$V_{CC} = 40V$	5.0	—	—	dB

Note: Pulse Width = 100 $\mu$ Sec  
 Duty Cycle = 10%

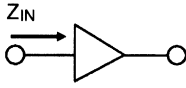
**TYPICAL PERFORMANCE**

**POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**

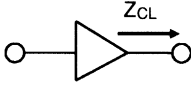


**IMPEDANCE DATA**

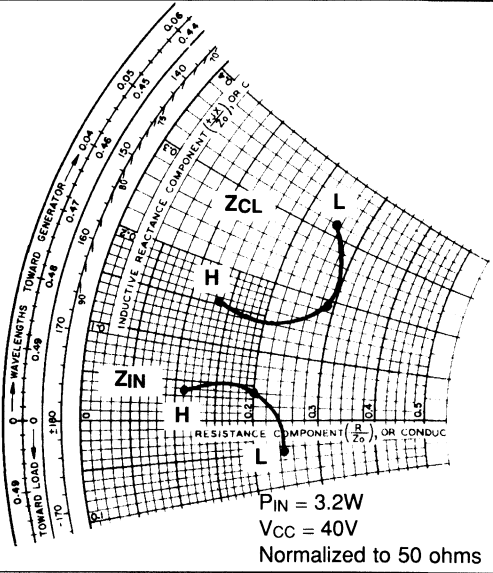
**TYPICAL INPUT IMPEDANCE**



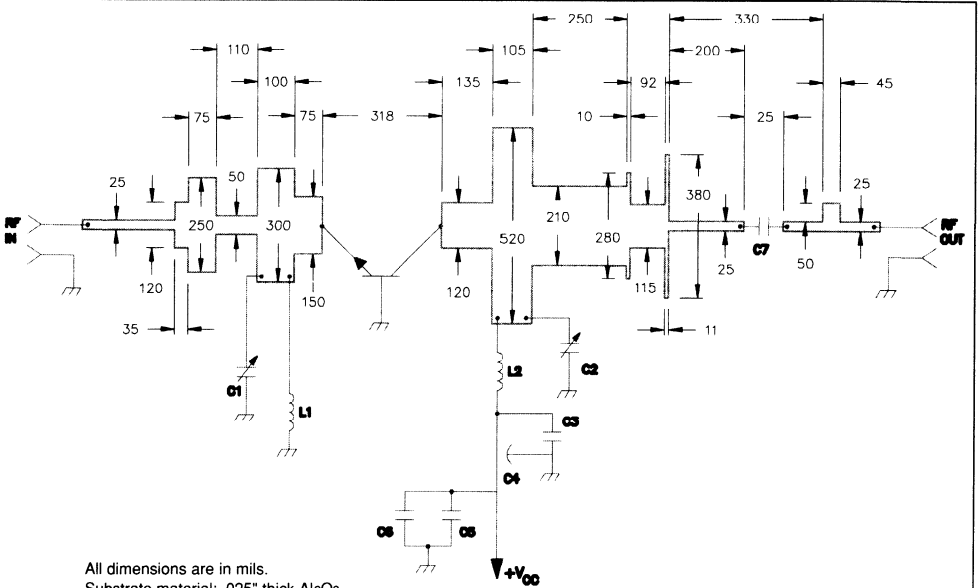
**TYPICAL COLLECTOR LOAD IMPEDANCE**



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 3.1 GHz	12.1 - j 1.6	12.7 + j 16.0
M = 3.3 GHz	10.0 + j 1.9	14.3 + j 9.5
H = 3.5 GHz	5.5 + j 1.7	6.8 + j 7.7



**TEST CIRCUIT**



All dimensions are in mils.  
 Substrate material: .025" thick Al<sub>2</sub>O<sub>3</sub>

- C1, C2 : 33 pF 50V Chip Capacitor
- C3 : 1 μF 50V Electrolytic Capacitor
- C4 : 1000 pF 200V Feedthru Capacitor

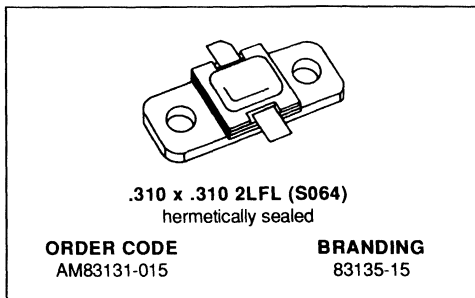
- C5 : 0.1 μF 50V Disc Ceramic Capacitor
- C6 : 100 μF 63V Electrolytic Capacitor
- C7 : 33 pF 50V Chip Capacitor
- L1, L2 : RF Choke, 2 Turns #26 Tinned Wire, .080" I.D.



**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

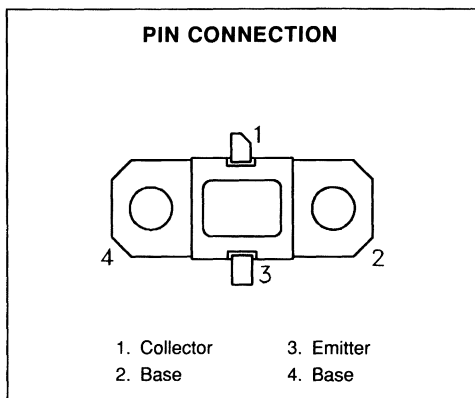
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 15$  W MIN. WITH 5.2 dB GAIN


**DESCRIPTION**

The AM83135-015 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is characterized at 100 $\mu$ sec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles, and temperatures, and can withstand a 3:1 output VSWR with a + 1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM83135-015 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	71	W
$I_c$	Device Current*	3.0	A
$V_{CC}$	Collector-Supply Voltage*	46	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	2.8	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

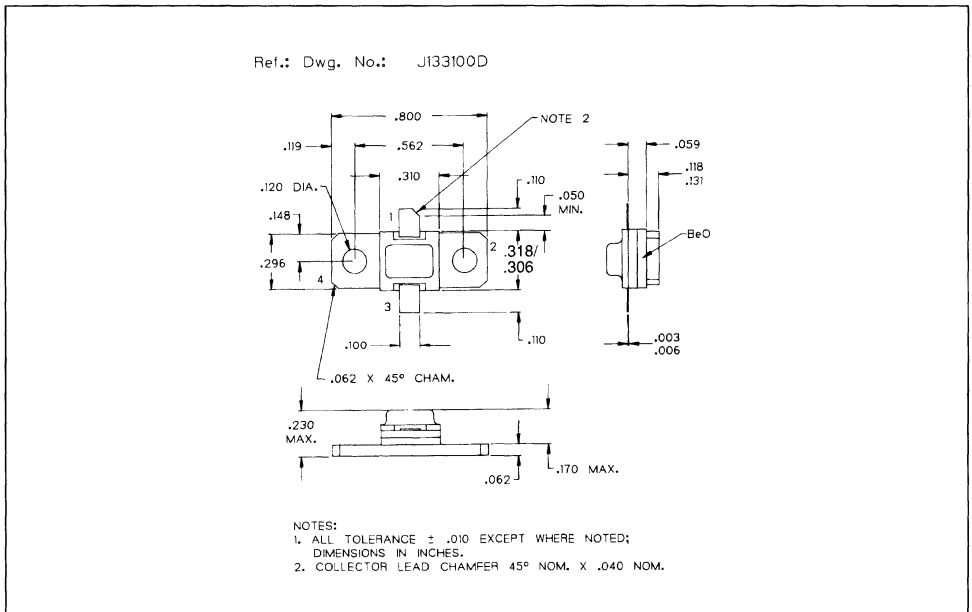
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 10mA$	$R_{BE} = 10\Omega$	55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 40V$	—	—	8	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	30	—	300	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.1 - 3.5GHz$	$P_{IN} = 4.5W$	$V_{CC} = 40V$	15	—	—	W
$\eta_C$	$f = 3.1 - 3.5GHz$	$P_{IN} = 4.5W$	$V_{CC} = 40V$	30	—	—	%
$G_P$	$f = 3.1 - 3.5GHz$	$P_{IN} = 4.5W$	$V_{CC} = 40V$	5.2	—	—	dB

Note: Pulse Width = 100 $\mu$ S  
 Duty Cycle = 10%

**PACKAGE MECHANICAL DATA**

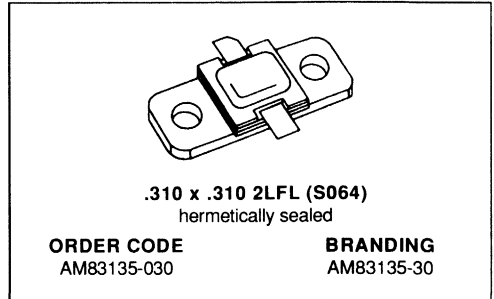




**RF & MICROWAVE TRANSISTORS  
 S-BAND RADAR APPLICATIONS**

PRELIMINARY DATA

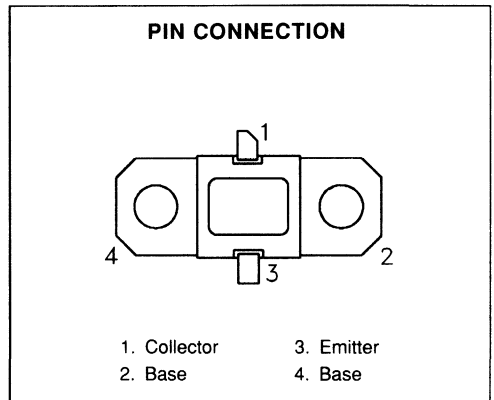
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 30$  W MIN. WITH 5.5 dB GAIN


**DESCRIPTION**

The AM83135-030 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is characterized at 100 $\mu$ sec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles, and temperatures, and withstand a 3:1 output VSWR with a + 1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM83135-030 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	133	W
$I_c$	Device Current*	6.0	A
$V_{CC}$	Collector-Supply Voltage*	46	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

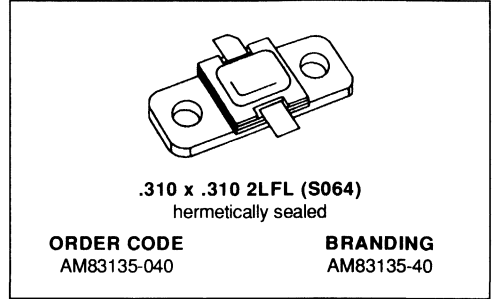
\*Applies only to rated RF amplifier operation



## RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 40$  W MIN. WITH 5.1 dB GAIN

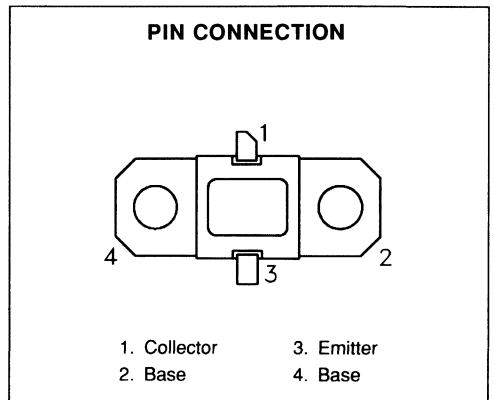


### DESCRIPTION

The AM83135-040 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is characterized at 10μsec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles, and temperatures, and can withstand a 3:1 output VSWR with a + 1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM83135-040 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	167	W
$I_c$	Device Current*	8.0	A
$V_{CC}$	Collector-Supply Voltage*	46	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.2	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

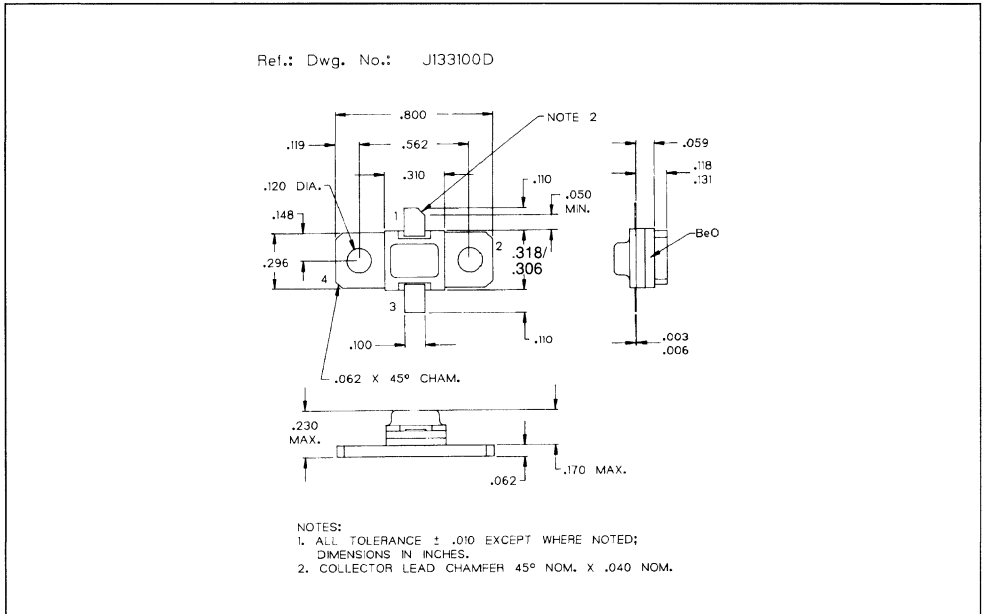
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 25mA	I <sub>E</sub> = 0mA	55	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 25mA	R <sub>BE</sub> = 10Ω	55	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 40V	—	—	20	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 3A	30	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 3.1 — 3.5GHz	P <sub>IN</sub> = 12.5W	V <sub>CC</sub> = 40V	40	—	—	W
η <sub>C</sub>	f = 3.1 — 3.5GHz	P <sub>IN</sub> = 12.5W	V <sub>CC</sub> = 40V	30	—	—	%
GP	f = 3.1 — 3.5GHz	P <sub>IN</sub> = 12.5W	V <sub>CC</sub> = 40V	5.1	—	—	dB

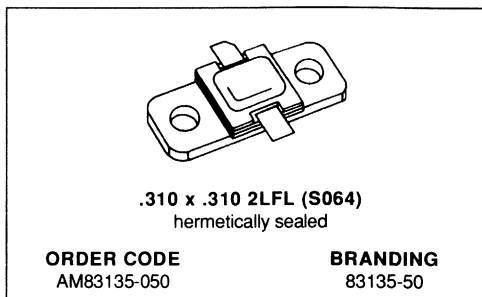
Note: Pulse Width = 100μs  
 Duty Cycle = 10%

PACKAGE MECHANICAL DATA



## RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

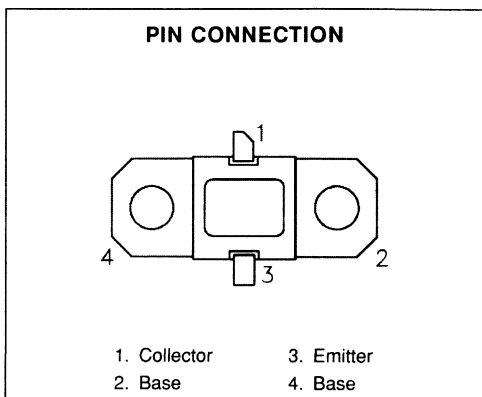
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- RUGGEDIZED VSWR 3:1 @ 1dB OVERDRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 50 W MIN. WITH 5.2 dB GAIN


**DESCRIPTION**

The AM83135-050 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is characterized at 10 μsec pulsewidth and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles and temperatures and can withstand a 3:1 output VSWR with a +1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM83135-050 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.


**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 125°C)	312	W
I <sub>C</sub>	Device Current*	8.0	A
V <sub>CC</sub>	Collector-Supply Voltage*	48	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.40	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$		55	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$		3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$		55	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 42V$		—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$		30	—	300	—

**DYNAMIC**

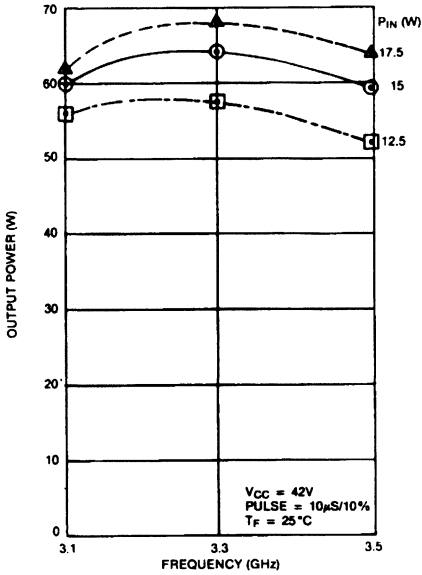
Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.1 \text{ — } 3.5GHz$	$P_{IN} = 15W$	$V_{CC} = 42V$		50	—		W
$\eta_C$	$f = 3.1 \text{ — } 3.5GHz$	$P_{IN} = 15W$	$V_{CC} = 42V$		30	—	—	%
$G_P$	$f = 3.1 \text{ — } 3.5GHz$	$P_{IN} = 15W$	$V_{CC} = 42V$		5.2	—	—	dB

Note: Pulse Width =  $10\mu Sec$

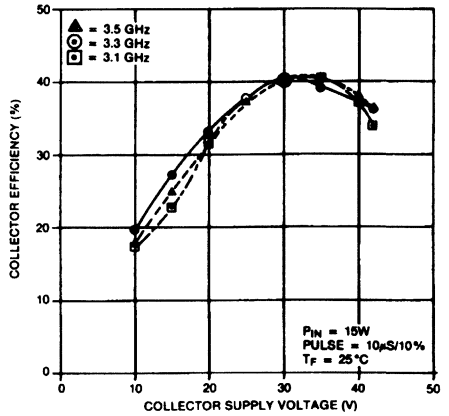
Duty Cycle = 10%

TYPICAL PERFORMANCE

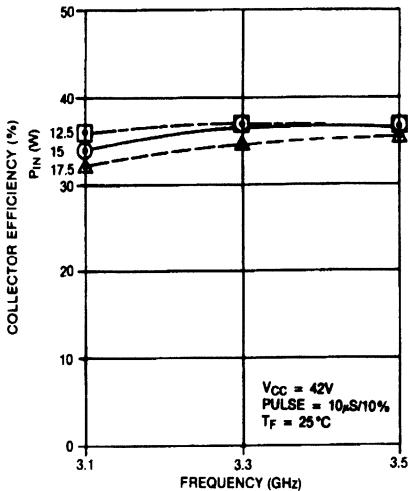
OUTPUT POWER vs FREQUENCY



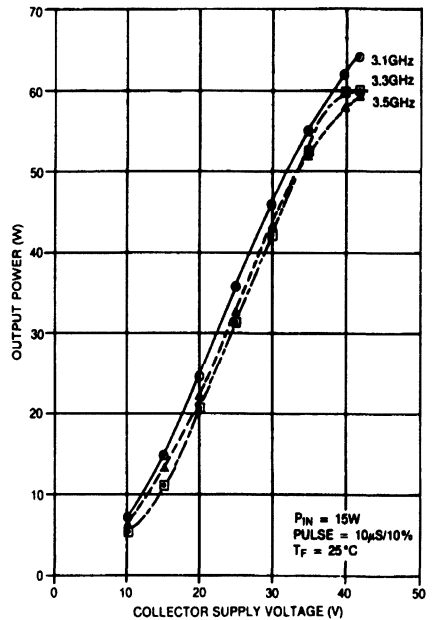
COLLECTOR EFFICIENCY vs COLLECTOR SUPPLY VOLTAGE



COLLECTOR EFFICIENCY vs FREQUENCY

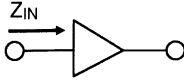


OUTPUT POWER vs COLLECTOR SUPPLY VOLTAGE

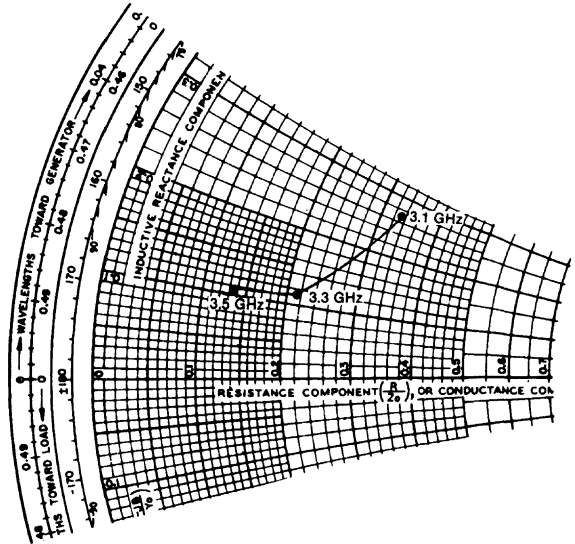


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

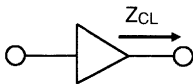


$P_{IN} = 15\text{ W}$   
 $V_{CC} = 42\text{ V}$   
 $Z_{O^*} = 50\text{ ohms}$

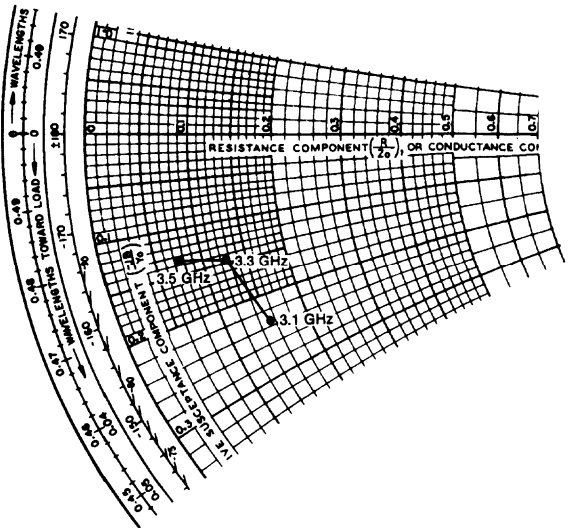


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 3.1 GHz	$16.5 + j 13.5$	$7.7 - j 11.8$
M = 3.3 GHz	$10.8 + j 5.5$	$6.5 - j 7.2$
H = 3.5 GHz	$6.7 + j 5.2$	$3.8 - j 6.7$

TYPICAL COLLECTOR LOAD IMPEDANCE



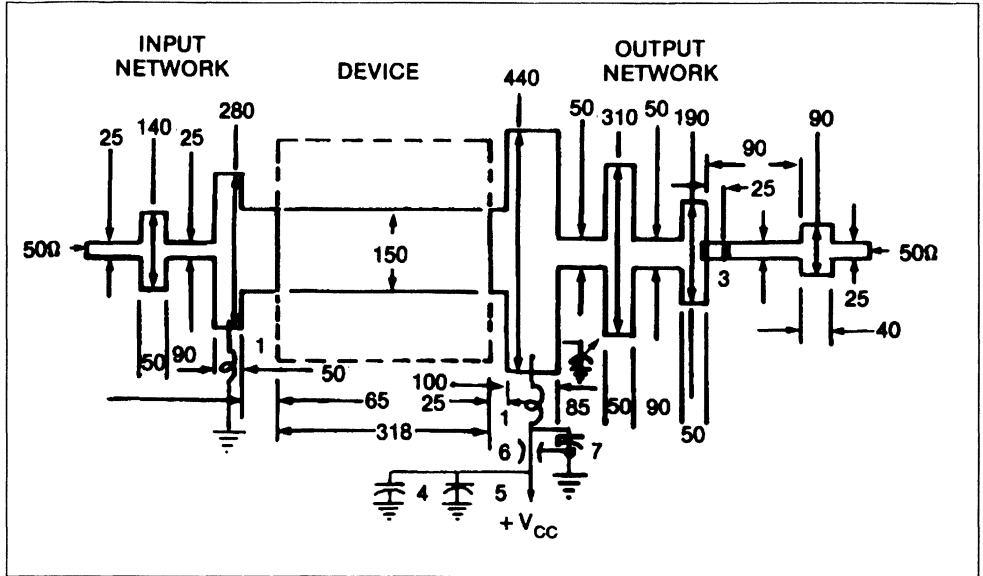
$P_{IN} = 15\text{ W}$   
 $V_{CC} = 42\text{ V}$   
 $Z_{O^*} = 50\text{ ohms}$



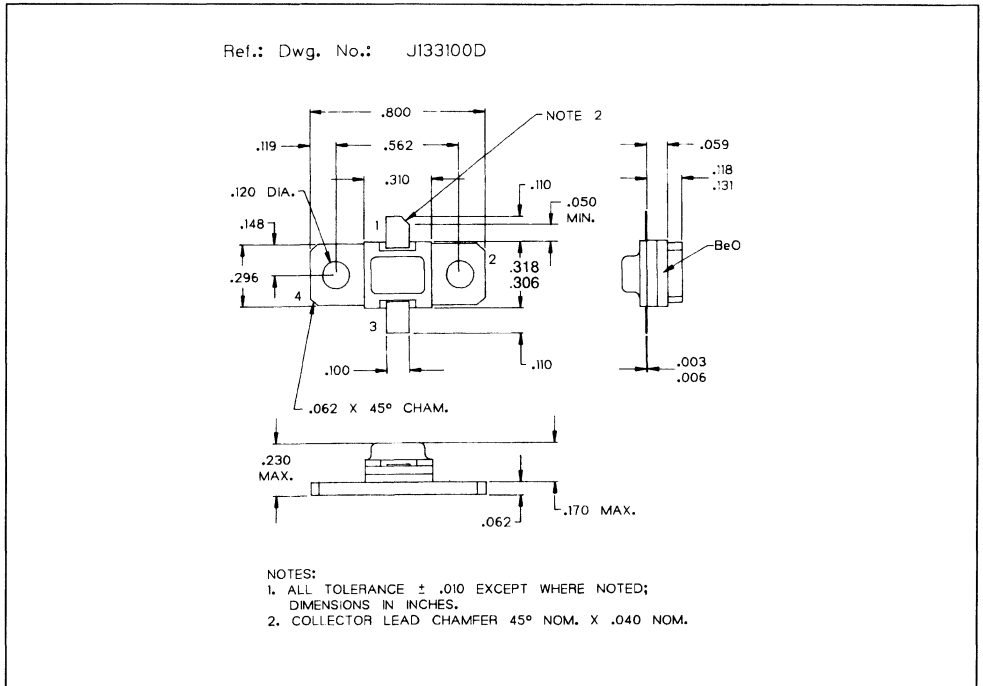
\*Normalized



TEST CIRCUIT



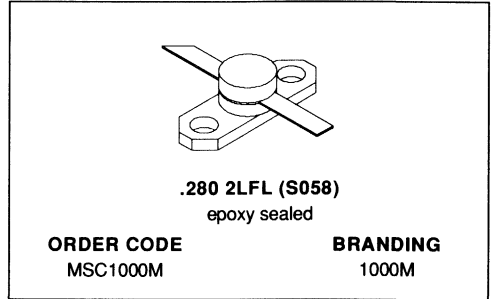
PACKAGE MECHANICAL DATA





**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

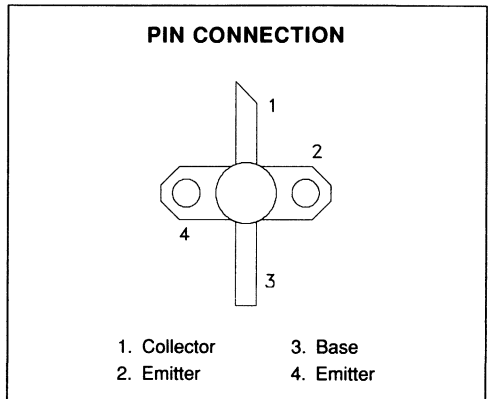
- RUGGEDIZED VSWR  $\infty:1$
- INPUT MATCHING
- LOW THERMAL RESISTANCE
- CLASS A OPERATION
- $P_{OUT} = 0.6$  W MIN. WITH 10.8 dB GAIN


**DESCRIPTION**

The MSC1000M is a Class A, common emitter transistor with an emitter ballasted Matrix geometry specifically designed for DME/IFF driver applications.

This device is capable of withstanding a  $\infty:1$  load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi-automatic wire bonding techniques ensure high reliability and product consistency.

The MSC1000M is housed in the IMPAC™ package with internal input matching.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* (See Safe Area)	—	W
$I_C$	Device Current*	300	mA
$V_{CE}$	Collector-Emitter Bias Voltage*	20	V
$T_J$	Junction Temperature (Pulsed RF Operation)	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	35	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	20	—	—	V
$I_{CES}$	$V_{CE} = 28V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

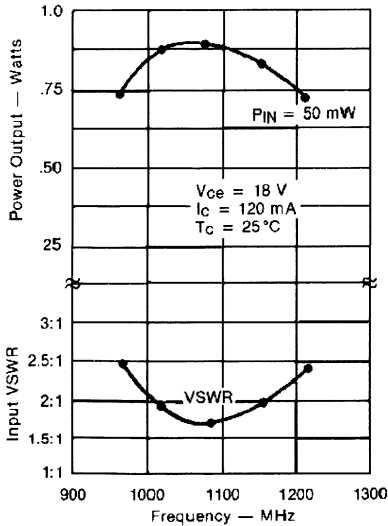
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150 MHz$	$P_{IN} = 50 mW$	$V_{CE} = 18 V$	0.6	0.85	—	W
$G_P$	$f = 1025 - 1150 MHz$	$P_{IN} = 50 mW$	$V_{CE} = 18 V$	10.8	12.3	—	dB

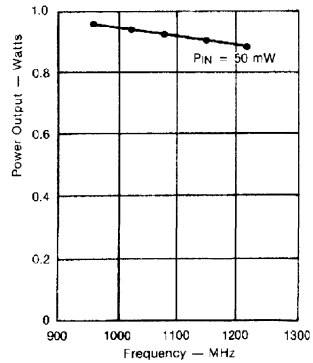
Note: Pulse Width = 10 $\mu$ Sec  $I_C = 120mA$   
 Duty Cycle = 1%

**TYPICAL PERFORMANCE**

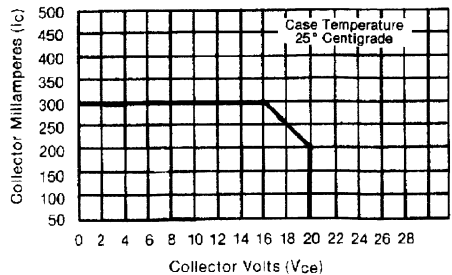
**BROADBAND POWER AMPLIFIER**



**NARROWBAND POWER OUTPUT vs FREQUENCY**

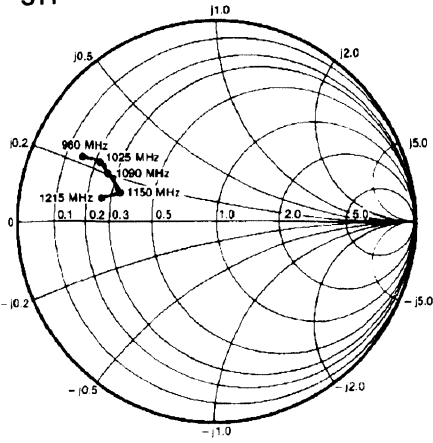


**MAXIMUM OPERATING AREA for FORWARD BIAS OPERATION**

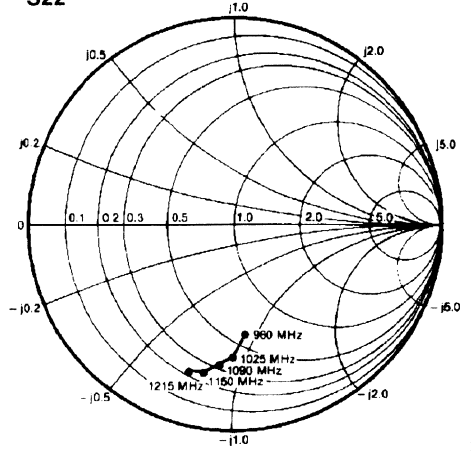


TYPICAL S-PARAMETERS

S11

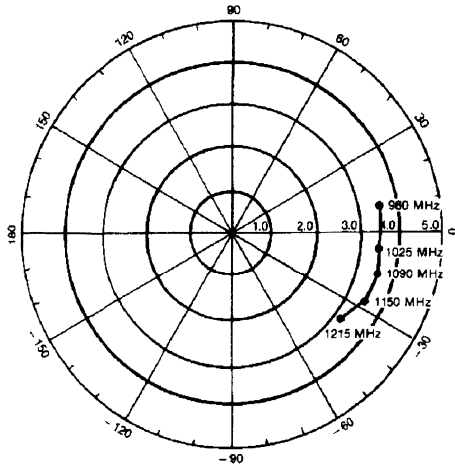


S22

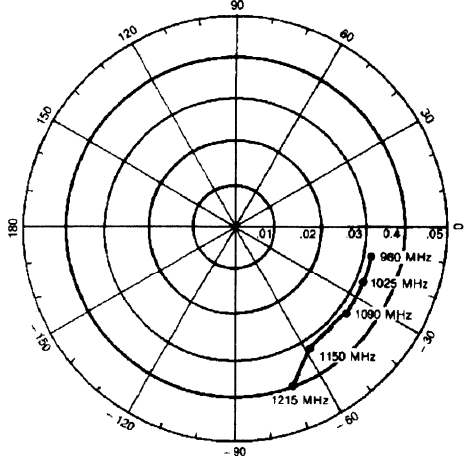


V<sub>CE</sub> = 18 V  
 I<sub>C</sub> = 120 mA  
 Z<sub>g</sub> = 50 ohms

S21

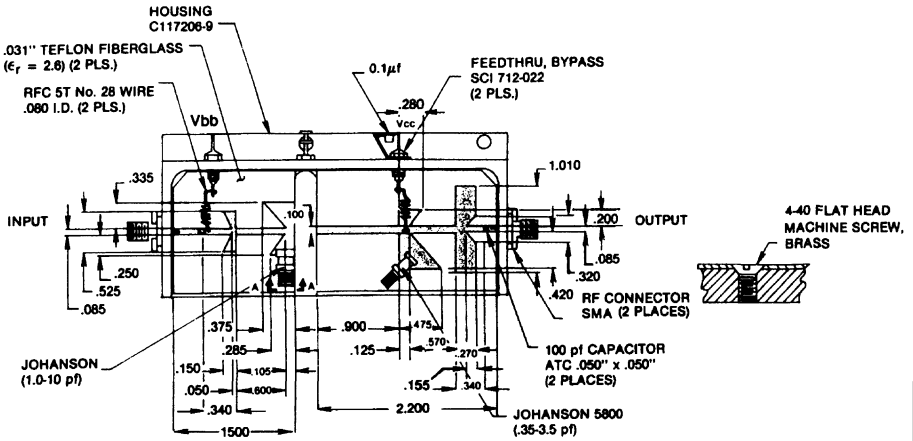


S12



TEST CIRCUIT

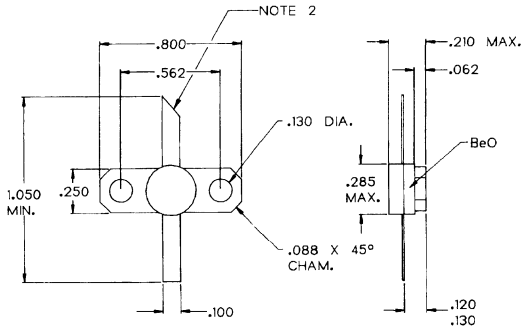
Ref.: Dwg No. C127297



All dimensions are in inches.

PACKAGE MECHANICAL DATA

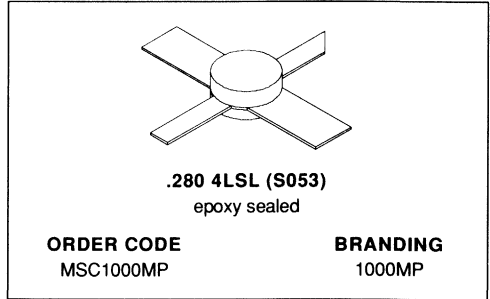
Ref.: Dwg. No.: J135039B



- NOTES:
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
  2. COLLECTOR LEAD SLANT CUT.

## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- RUGGEDIZED VSWR  $\infty:1$
- INPUT MATCHING
- LOW THERMAL RESISTANCE
- CLASS A OPERATION
- $P_{OUT} = 0.6$  W MIN. WITH 10.8 dB GAIN

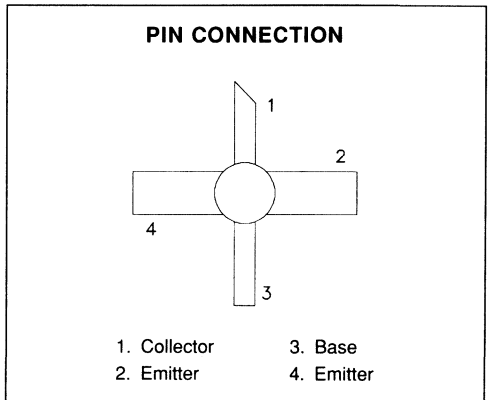


### DESCRIPTION

The MSC1000MP is a Class A, common emitter transistor with an emitter ballasted Matrix geometry specifically designed for DME/IFF driver applications.

This device is capable of withstanding a  $\infty:1$  load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi-automatic wire bonding techniques ensure high reliability and product consistency.

The MSC1000MP is housed in the IMPAC™ package with internal input matching.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* (See Safe Area)	—	W
$I_C$	Device Current*	300	mA
$V_{CE}$	Collector-Emitter Bias Voltage*	20	V
$T_J$	Junction Temperature (Pulsed RF Operation)	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	35	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

# MSC1000MP

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	20	—	—	V
$I_{CES}$	$V_{CE} = 28V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

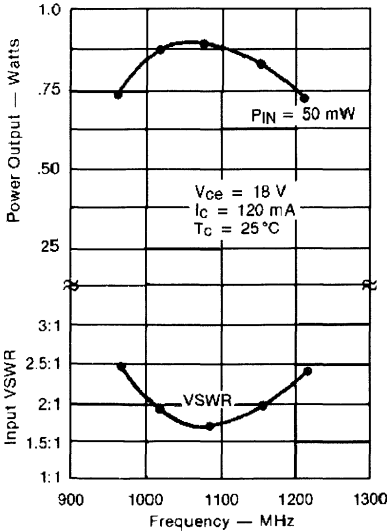
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150 MHz$	$P_{IN} = 50 mW$	$V_{CE} = 18 V$	0.6	0.85	—	W
$G_P$	$f = 1025 - 1150 MHz$	$P_{IN} = 50 mW$	$V_{CE} = 18 V$	10.8	12.3	—	dB

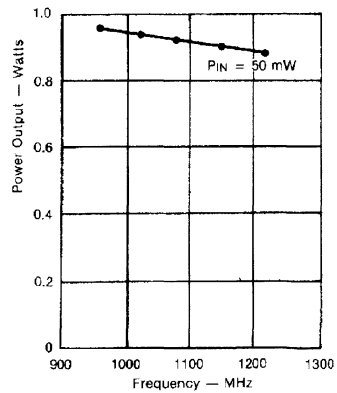
Note: Pulse Width =  $10\mu Sec$        $I_C = 120mA$   
 Duty Cycle = 1%

### TYPICAL PERFORMANCE

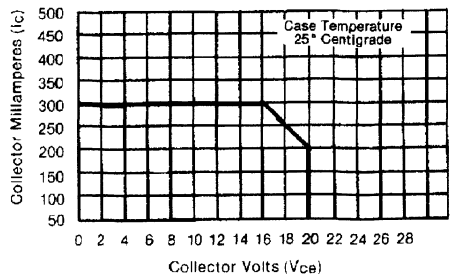
#### BROADBAND POWER AMPLIFIER



#### NARROWBAND POWER OUTPUT vs FREQUENCY



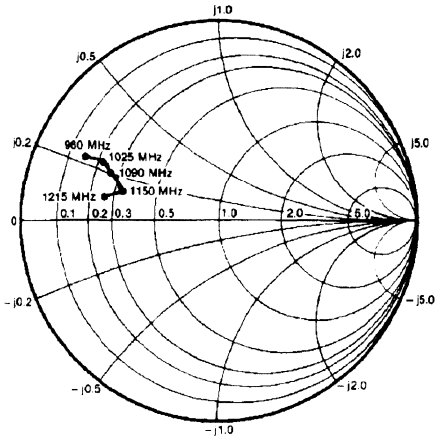
#### MAXIMUM OPERATING AREA for FORWARD BIAS OPERATION



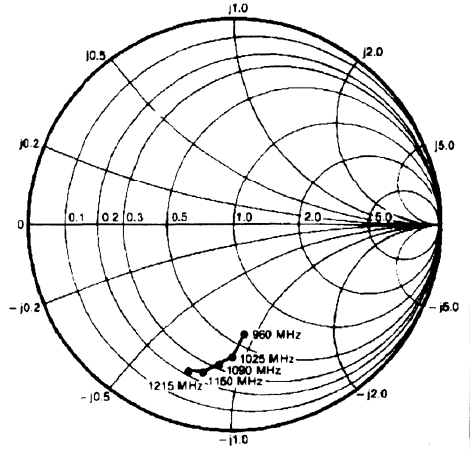


TYPICAL S-PARAMETERS

S11

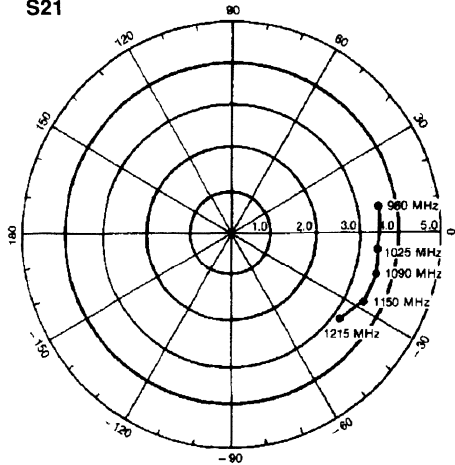


S22

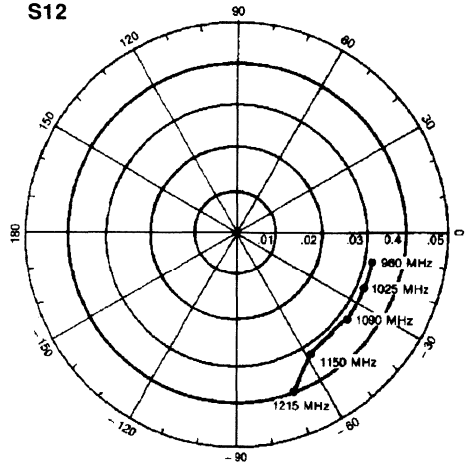


$V_{CE} = 18\text{ V}$   
 $I_C = 120\text{ mA}$   
 $Z_g = 50\text{ ohms}$

S21

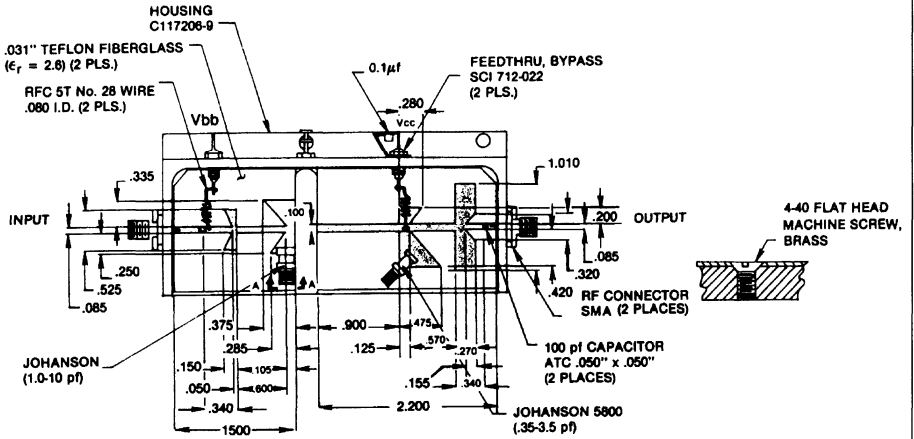


S12



TEST CIRCUIT

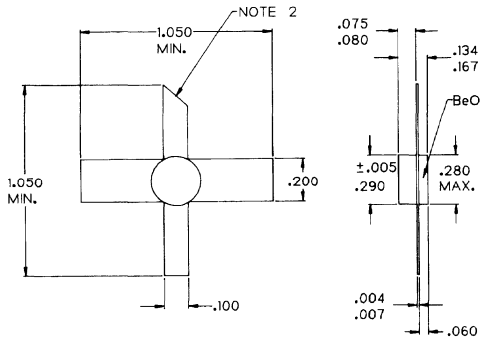
Ref.: Dwg. No. C127297



All dimensions are in inches.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135032E

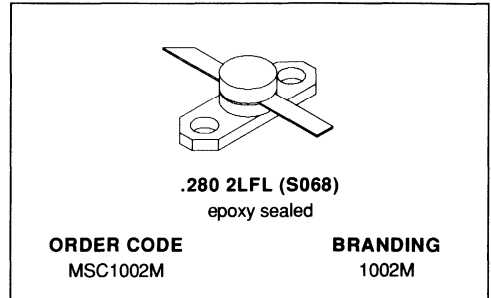


NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.

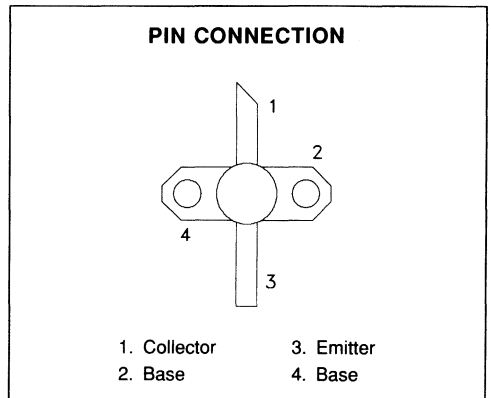
**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- RUGGEDIZED VSWR  $\infty:1$
- INPUT MATCHING
- LOW THERMAL RESISTANCE
- $P_{OUT} = 2.0$  W MIN. WITH 9.0 dB GAIN


**DESCRIPTION**

The MSC1002M is a low level Class C transistor with an overlay, emitter site ballasted geometry specifically designed for avionics driver applications. This device is capable of withstanding an  $\infty:1$  load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi-automatic bonding techniques ensure high reliability and product consistency.

The MSC1002M is housed in the IMPAC™ package with internal input matching.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	10	W
$I_C$	Device Current*	250	mA
$V_{CC}$	Collector-Supply Voltage*	37	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	10.0	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

# MSC1002M

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CES}$	$V_{CE} = 35V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	30	—	300	—

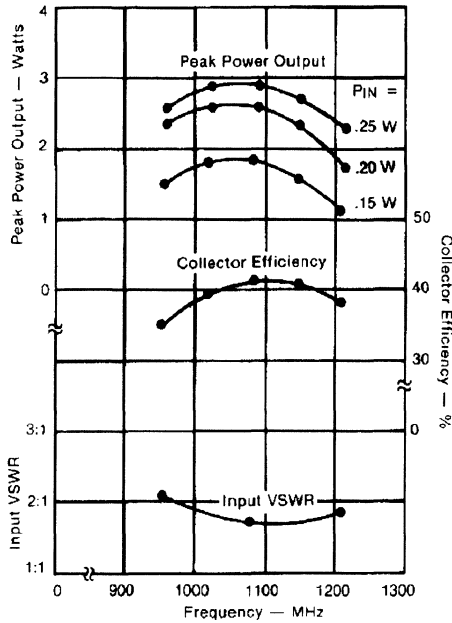
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150$ MHz	$P_{IN} = 0.25$ W	$V_{CC} = 35$ V	2.0	2.7	—	W
$\eta_C$	$f = 1025 - 1150$ MHz	$P_{IN} = 0.25$ W	$V_{CC} = 35$ V	35	39	—	%
$G_P$	$f = 1025 - 1150$ MHz	$P_{IN} = 0.25$ W	$V_{CC} = 35$ V	9.0	10.3	—	dB

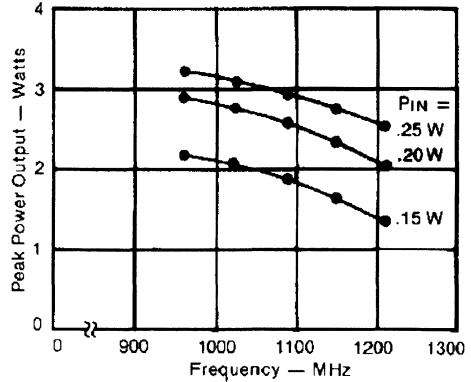
Note: Pulse Width = 10 $\mu$ Sec  
Duty Cycle = 1%

TYPICAL PERFORMANCE

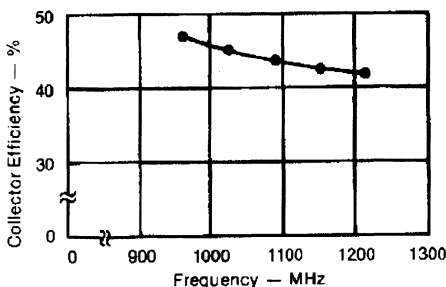
BROADBAND POWER AMPLIFIER



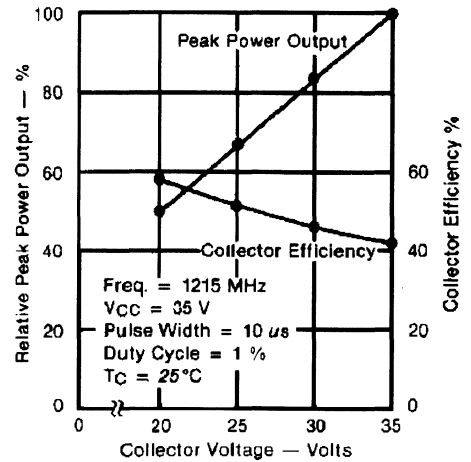
NARROWBAND PEAK POWER OUTPUT vs FREQUENCY



NARROWBAND COLLECTOR EFFICIENCY vs FREQUENCY

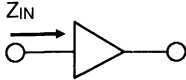


RELATIVE PEAK POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE

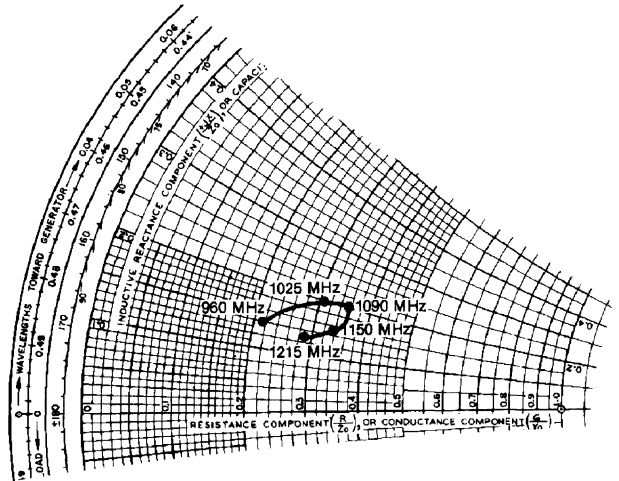


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

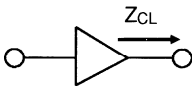


$P_{IN} = 250 \text{ MW}$   
 $V_{CC} = 35 \text{ V}$   
 Normalized to 50 ohms

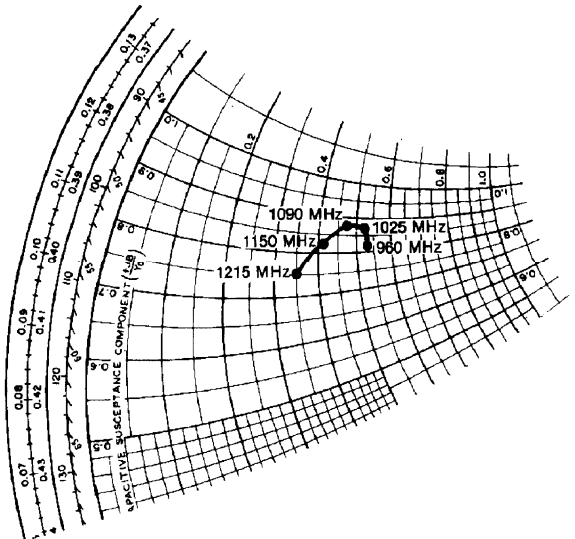


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
960 MHz	$10.7 + j 7.0$	$26.5 + j 41.0$
1025 MHz	$15.3 + j 10.0$	$26.0 + j 43.5$
1090 MHz	$17.8 + j 10.2$	$23.5 + j 44.0$
1150 MHz	$16.8 + j 15.0$	$20.5 + j 41.5$
1215 MHz	$14.4 + j 13.0$	$17.5 + j 37.5$

TYPICAL COLLECTOR LOAD IMPEDANCE

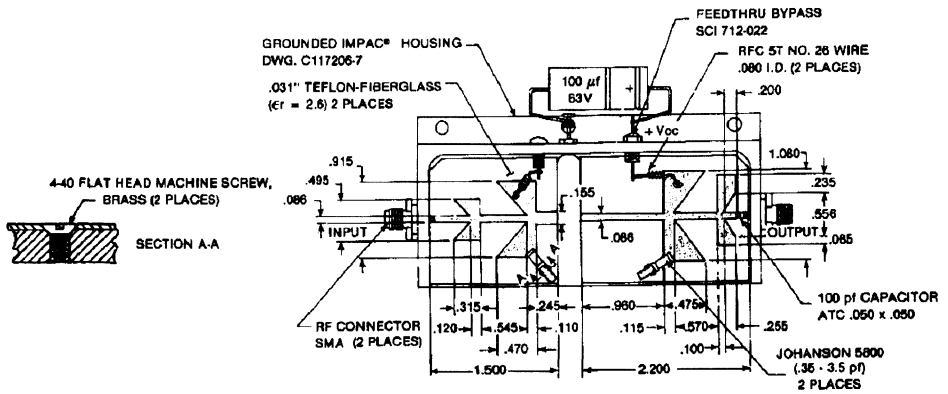


$P_{IN} = 250 \text{ MW}$   
 $V_{CC} = 35 \text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

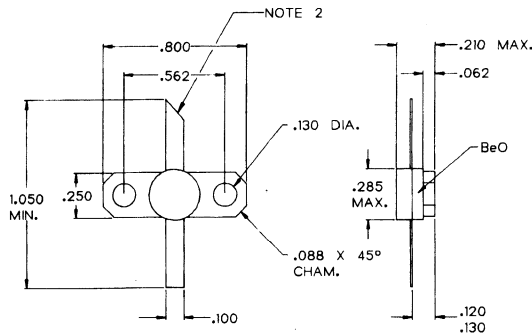
Ref.: Dwg. No. C127298



All dimensions are in inches.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135039B



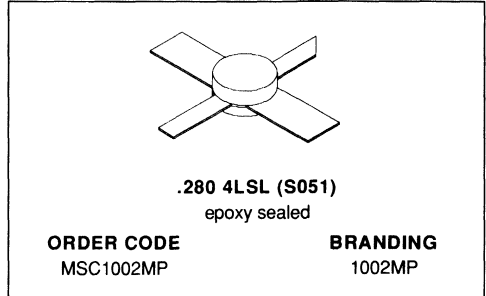
- NOTES:
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
  2. COLLECTOR LEAD SLANT CUT.





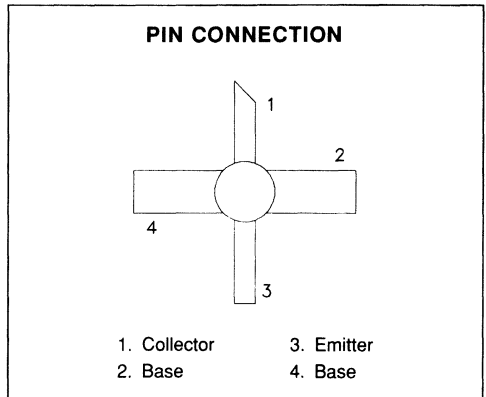
**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- RUGGEDIZED VSWR  $\infty:1$
- INPUT MATCHING
- LOW THERMAL RESISTANCE
- $P_{OUT} = 2.0$  W MIN. WITH 9.0 dB GAIN


**DESCRIPTION**

The MSC1002MP is a low level Class C transistor with an overlay, emitter site ballasted geometry specifically designed for avionics driver applications. This device is capable of withstanding an  $\infty:1$  load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi-automatic bonding techniques ensure high reliability and product consistency.

The MSC1002MP is housed in the IMPAC™ package with internal input matching.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	10	W
$I_C$	Device Current*	250	mA
$V_{CC}$	Collector-Supply Voltage*	37	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	10.0	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CES}$	$V_{CE} = 35V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	30	—	300	—

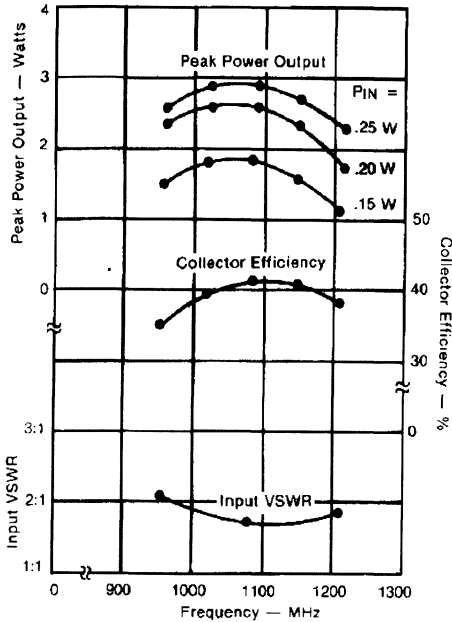
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150 MHz$	$P_{IN} = 0.25 W$	$V_{CC} = 35 V$	2.0	2.7	—	W
$\eta_C$	$f = 1025 - 1150 MHz$	$P_{IN} = 0.25 W$	$V_{CC} = 35 V$	35	39	—	%
$G_P$	$f = 1025 - 1150 MHz$	$P_{IN} = 0.25 W$	$V_{CC} = 35 V$	9.0	10.3	—	dB

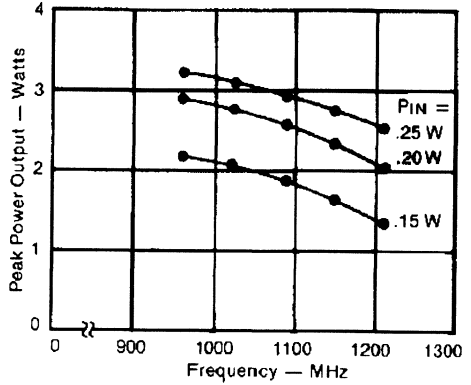
Note: Pulse Width =  $10\mu Sec$   
 Duty Cycle = 1%

TYPICAL PERFORMANCE

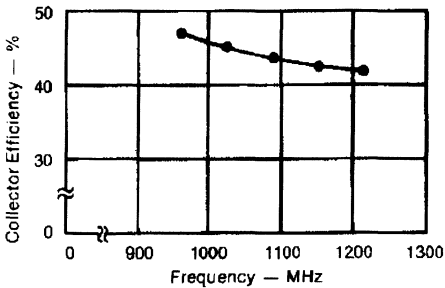
BROADBAND POWER AMPLIFIER



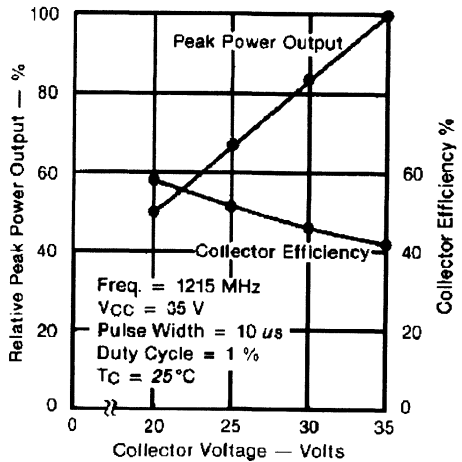
NARROWBAND PEAK POWER OUTPUT vs FREQUENCY



NARROWBAND COLLECTOR EFFICIENCY vs FREQUENCY

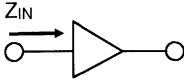


RELATIVE PEAK POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE

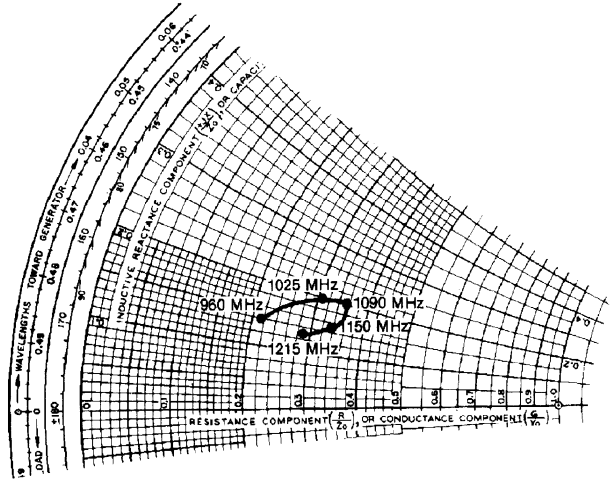


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

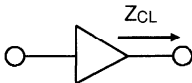


$P_{IN} = 250 \text{ MW}$   
 $V_{CC} = 35 \text{ V}$   
 Normalized to 50 ohms

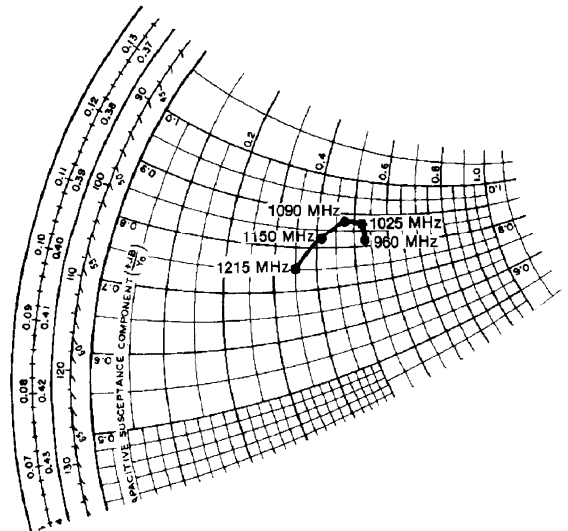


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
960 MHz	$10.7 + j 7.0$	$26.5 + j 41.0$
1025 MHz	$15.3 + j 10.0$	$26.0 + j 43.5$
1090 MHz	$17.8 + j 10.2$	$23.5 + j 44.0$
1150 MHz	$16.8 + j 15.0$	$20.5 + j 41.5$
1215 MHz	$14.4 + j 13.0$	$17.5 + j 37.5$

TYPICAL COLLECTOR LOAD IMPEDANCE



$P_{IN} = 250 \text{ MW}$   
 $V_{CC} = 35 \text{ V}$   
 Normalized to 50 ohms

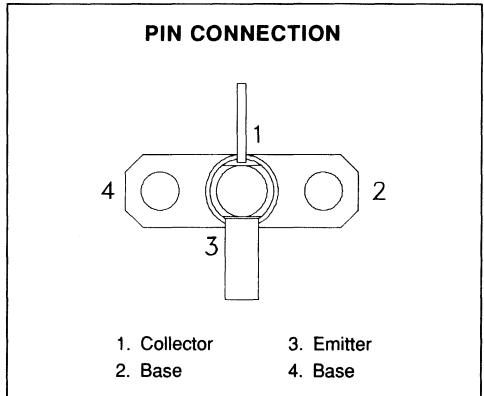
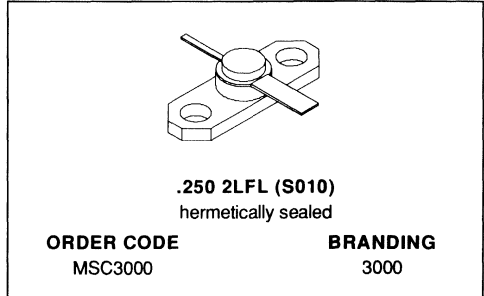






**RF & MICROWAVE TRANSISTORS  
 GENERAL PURPOSE AMPLIFIER APPLICATIONS**

- COMMON BASE
- HIGH GAIN & EFFICIENCY TO 3.5 GHz
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 0.5 \text{ W MIN. WITH } 7.0 \text{ dB GAIN @ } 3 \text{ GHz}$


**DESCRIPTION**

The MSC3000 is a hermetically sealed silicon NPN common base transistor featuring a unique matrix geometry to provide high gain, efficiency and output power at frequencies up to 3500 MHz.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 85^{\circ}\text{C}$ )	2.5	W
$I_c$	Device Current*	0.1	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	45	$^{\circ}\text{C/W}$
---------------	-----------------------------------	----	----------------------

\*Applies only to rated RF amplifier operation

# MSC3000

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

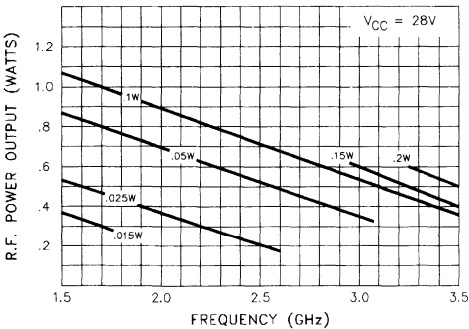
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	50	—	—	V
$I_{CBO}$	$V_{CE} = 28V$		—	—	250	$\mu A$
$h_{FE}$	$V_{CE} = 5V$	$I_C = 50mA$	15	—	120	—

### DYNAMIC

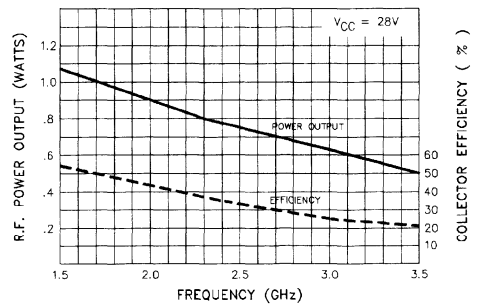
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.0\text{ GHz}$	$P_{IN} = 0.10\text{ W}$	$V_{CC} = 28\text{ V}$	0.5	—	—	W
$\eta_C$	$f = 3.0\text{ GHz}$	$P_{IN} = 0.10\text{ W}$	$V_{CC} = 28\text{ V}$	25	—	—	%
$G_P$	$f = 3.0\text{ GHz}$	$P_{IN} = 0.10\text{ W}$	$V_{CC} = 28\text{ V}$	7.0	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	2.5	pF

### TYPICAL PERFORMANCE

**POWER OUTPUT vs FREQUENCY**



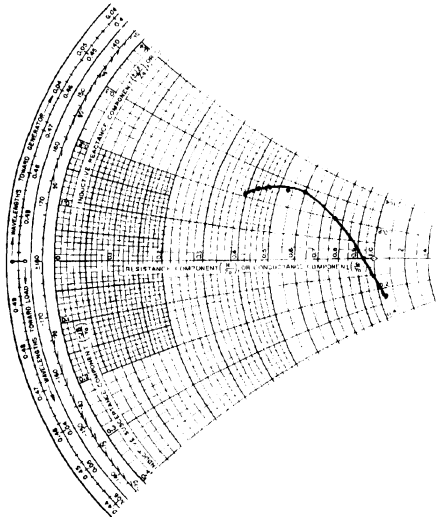
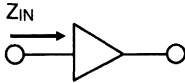
**SATURATED POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**





IMPEDANCE DATA

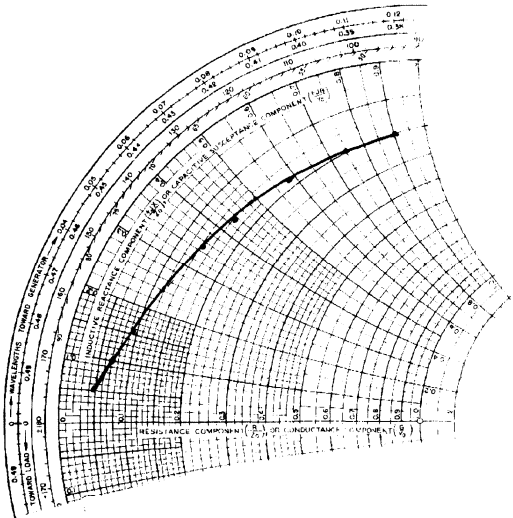
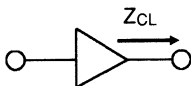
TYPICAL INPUT IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1.5 GHz	19.5 + j 10.5	10.0 + j 45.0
1.7 GHz	21.5 + j 12.0	10.0 + j 37.5
2.0 GHz	23.5 + j 13.0	9.1 + j 29.0
2.3 GHz	26.5 + j 13.0	8.0 + j 21.5
2.5 GHz	30.0 + j 14.0	7.1 + j 17.5
3.0 GHz	38.0 + j 10.0	4.5 + j 7.8
3.3 GHz	47.0 + j 0.0	3.5 + j 5.0
3.5 GHz	53.0 - j 12.5	2.5 + j 2.5

P<sub>IN</sub> = 0.1 W  
 V<sub>CC</sub> = 28 V  
 Normalized to 50 ohms

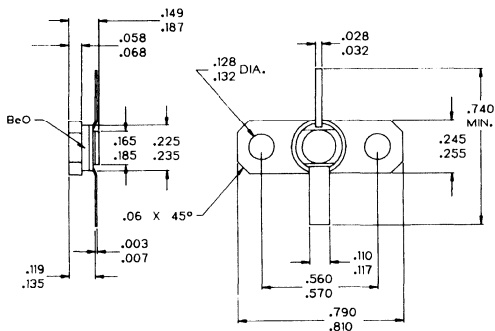
TYPICAL COLLECTOR LOAD IMPEDANCE





PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: JI35021C



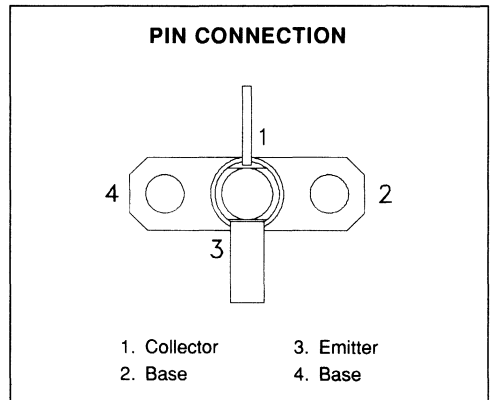
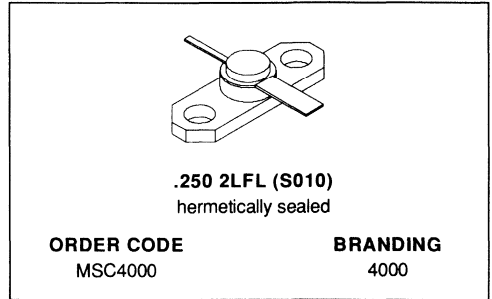
NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.



## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- VSWR CAPABILITY 3:1 @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 0.5 \text{ W MIN. WITH } 5.0 \text{ dB GAIN @ } 4.0 \text{ GHz}$



### DESCRIPTION

The MSC4000 is a common base hermetically sealed silicon NPN microwave power transistor featuring a unique Microgrid™ structure. This device is capable of withstanding a 3:1 load VSWR at any phase angle under rated conditions.

The MSC4000 was designed for Class C amplifier applications in the 2.0 - 4.4 GHz frequency range.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	3.89	W
$I_C$	Device Current*	0.15	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	45	$^{\circ}\text{C/W}$
---------------	-----------------------------------	----	----------------------

\*Applies only to rated RF amplifier operation

# MSC4000

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

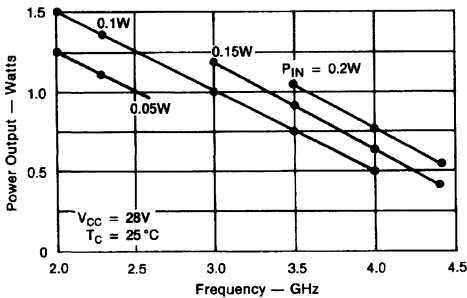
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 1mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 5mA	R <sub>BE</sub> = 10Ω	45	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	0.5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 100mA	15	—	120	—

### DYNAMIC

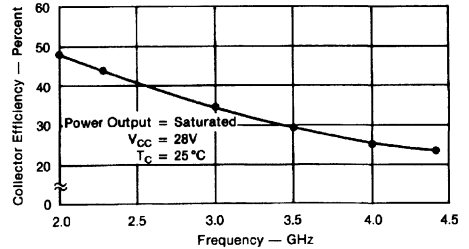
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 4.0 GHz	P <sub>IN</sub> = 0.16 W	V <sub>CC</sub> = 28 V	0.5	0.60	—	W
η <sub>C</sub>	f = 4.0 GHz	P <sub>IN</sub> = 0.16 W	V <sub>CC</sub> = 28 V	25	27	—	%
G <sub>P</sub>	f = 4.0 GHz	P <sub>IN</sub> = 0.16 W	V <sub>CC</sub> = 28 V	5.0	5.8	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	2.5	pF

### TYPICAL PERFORMANCE

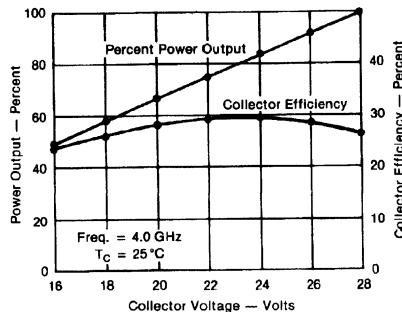
**TYPICAL POWER OUTPUT vs FREQUENCY**



**TYPICAL COLLECTOR EFFICIENCY vs FREQUENCY**

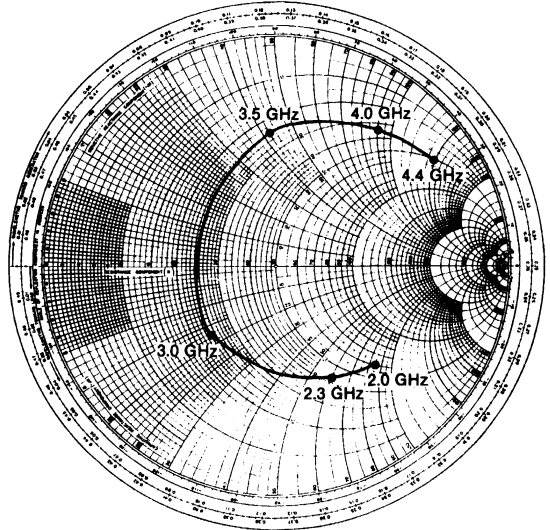
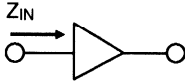


**RELATIVE POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE**



IMPEDANCE DATA

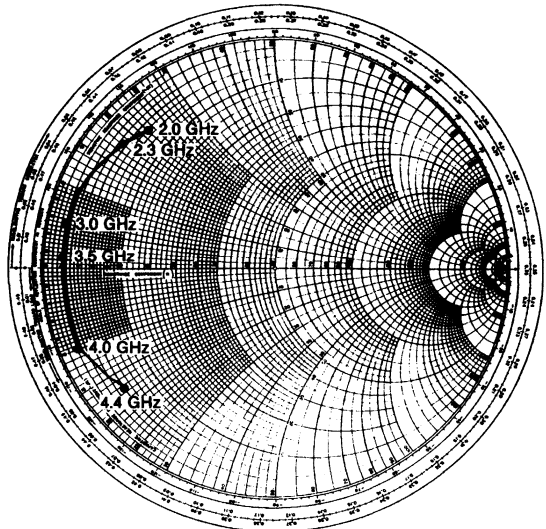
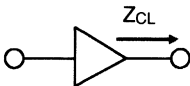
TYPICAL INPUT IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
2.0 GHz	60.0 - j 85.0	6.0 + j 22.0
2.3 GHz	42.0 - j 60.0	4.5 + j 18.0
3.0 GHz	24.0 - j 17.5	2.0 + j 5.5
3.5 GHz	24.0 + j 42.0	2.0 + j 1.3
4.0 GHz	33.0 + j 90.0	2.0 - j 10.0
4.4 GHz	50.0 + j 150.0	5.0 - j 17.5

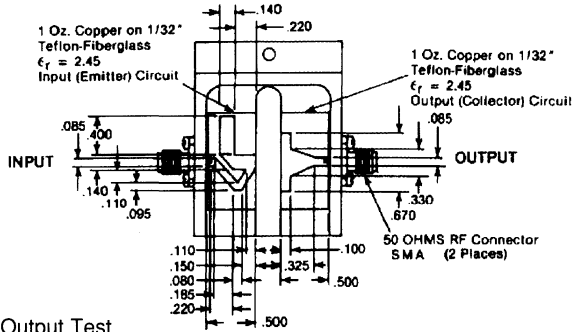
P<sub>OUT</sub> = Saturated  
 V<sub>CC</sub> = 28 V  
 Normalized to 50 ohms

TYPICAL COLLECTOR LOAD IMPEDANCE

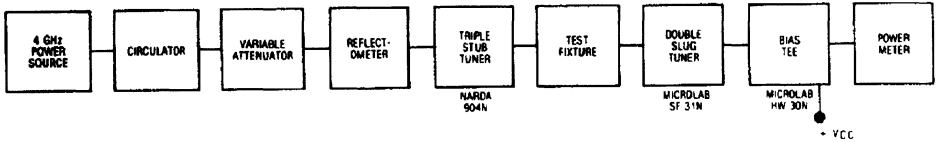


TEST CIRCUIT

Ref.: Dwg. No. C125504B



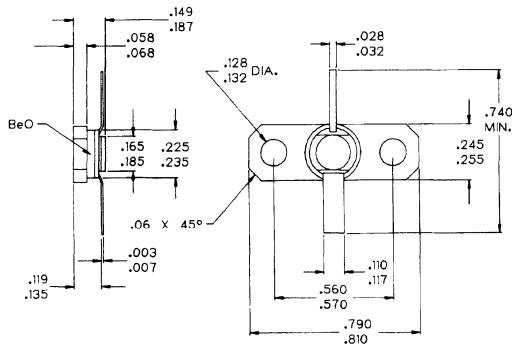
RF Amplifier Power Output Test



All dimensions are in inches.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C

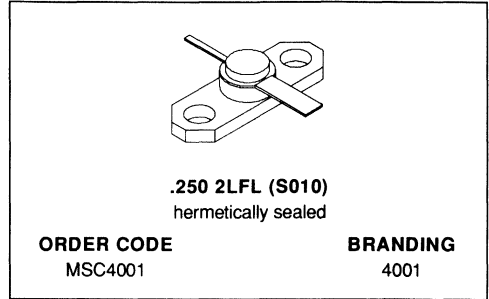


NOTES:  
 1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
 DIMENSIONS IN INCHES.



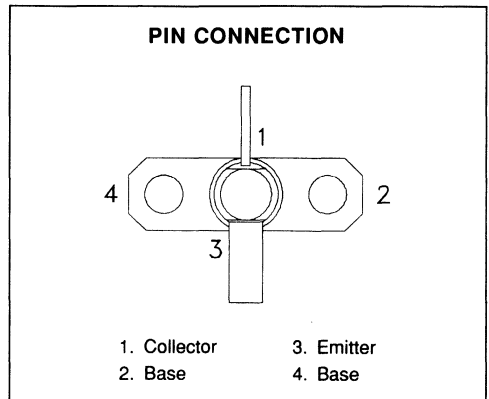
**RF & MICROWAVE TRANSISTORS  
 GENERAL PURPOSE AMPLIFIER APPLICATIONS**

- VSWR CAPABILITY 3:1 @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 1.0$  W MIN. WITH 5.0 dB GAIN @ 4.0 GHz


**DESCRIPTION**

The MSC4001 is a common base hermetically sealed silicon NPN microwave power transistor featuring a unique Microgrid™ structure. This device is capable of withstanding a 3:1 load VSWR at any phase angle under rated conditions.

The MSC4001 was designed for Class C amplifier applications in the 2.0 - 4.4 GHz frequency range.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	7.0	W
$I_C$	Device Current*	0.25	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	25	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

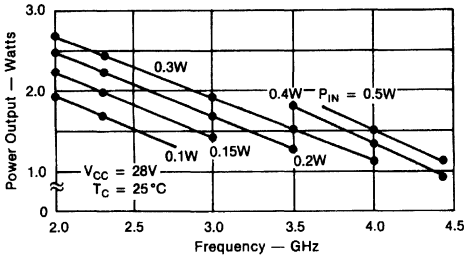
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

**DYNAMIC**

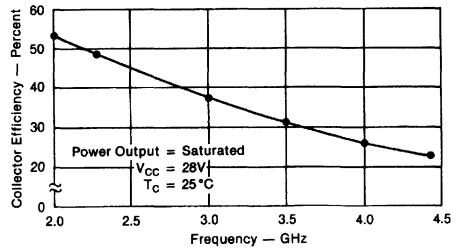
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 4.0\text{ GHz}$	$P_{IN} = 0.32\text{ W}$	$V_{CC} = 28\text{ V}$	1.0	1.2	—	W
$\eta_C$	$f = 4.0\text{ GHz}$	$P_{IN} = 0.32\text{ W}$	$V_{CC} = 28\text{ V}$	25	27	—	%
$G_P$	$f = 4.0\text{ GHz}$	$P_{IN} = 0.32\text{ W}$	$V_{CC} = 28\text{ V}$	5.0	5.8	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	3.6	pF

**TYPICAL PERFORMANCE**

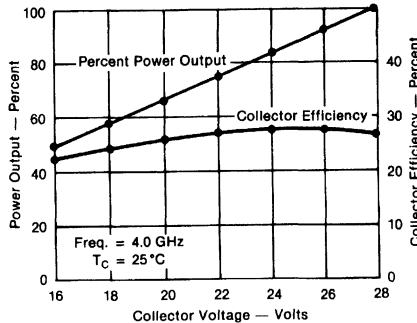
**TYPICAL POWER OUTPUT vs FREQUENCY**



**TYPICAL COLLECTOR EFFICIENCY vs FREQUENCY**

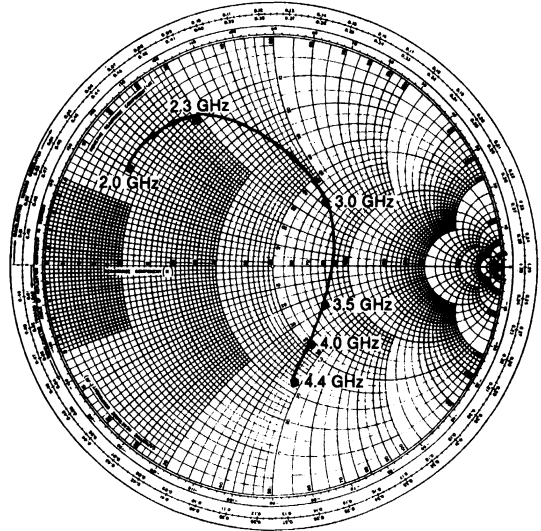
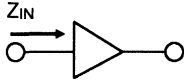


**RELATIVE POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE**



IMPEDANCE DATA

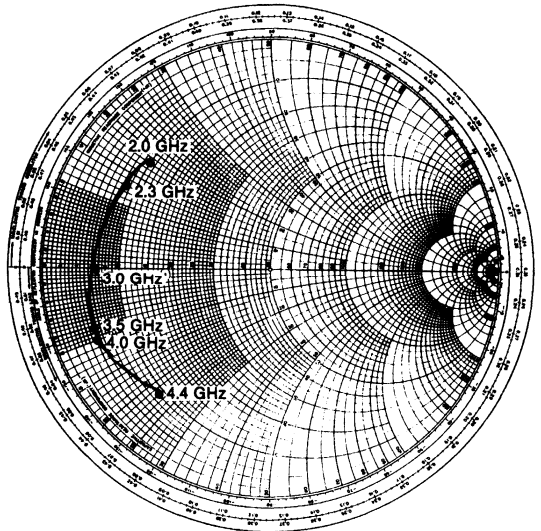
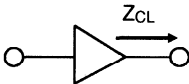
TYPICAL INPUT  
IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
2.0 GHz	7.5 + j 15.0	10.0 + j 18.0
2.3 GHz	11.0 + j 29.0	8.5 + j 13.0
3.0 GHz	65.0 + j 42.5	6.0 + j 0.0
3.5 GHz	65.0 - j 27.5	5.0 - j 8.5
4.0 GHz	53.0 - j 42.5	5.0 - j 10.0
4.4 GHz	33.0 - j 48.0	9.0 - j 22.0

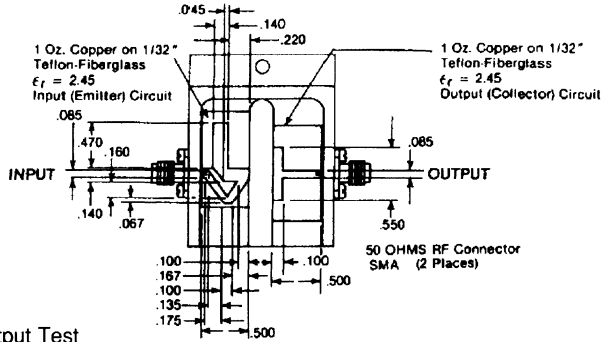
P<sub>OUT</sub> = Saturated  
V<sub>CC</sub> = 28 V  
Normalized to 50 ohms

TYPICAL COLLECTOR  
LOAD IMPEDANCE

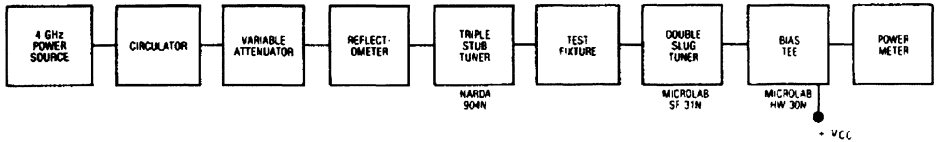


TEST CIRCUIT

Ref.: Dwg. No. C125505B



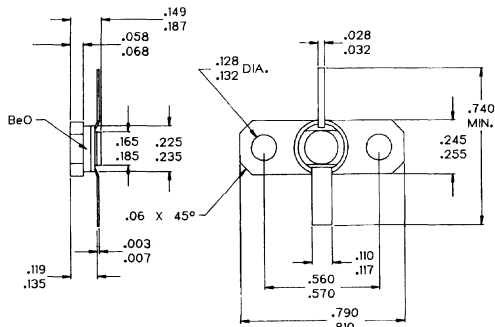
RF Amplifier Power Output Test



All dimensions are in inches.

PACKAGE MECHANICAL DATA

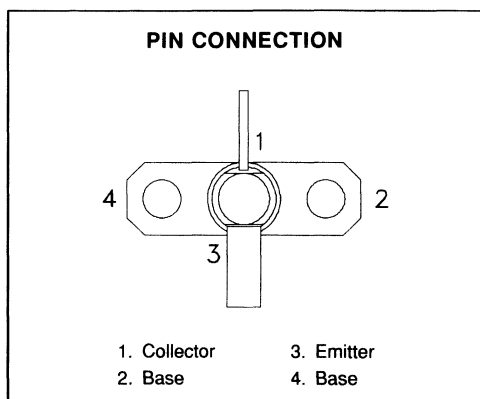
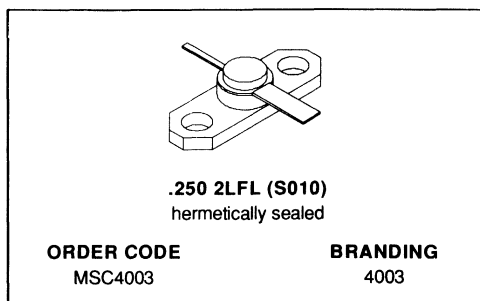
Ref.: Dwg. No.: J135021C



NOTES:  
 1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
 DIMENSIONS IN INCHES.

## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- VSWR CAPABILITY 3:1 @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 2.5 \text{ W MIN. WITH } 5.0 \text{ dB GAIN @ } 4.0 \text{ GHz}$



### DESCRIPTION

The MSC4003 is a common base hermetically sealed silicon NPN microwave power transistor featuring a unique Microgrid™ structure. This device is capable of withstanding a 3:1 load VSWR at any phase angle under rated conditions.

The MSC4003 was designed for Class C amplifier applications in the 2.0 - 4.4 GHz frequency range.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	14.0	W
$I_c$	Device Current*	0.5	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	12.5	$^{\circ}\text{C/W}$
---------------	-----------------------------------	------	----------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

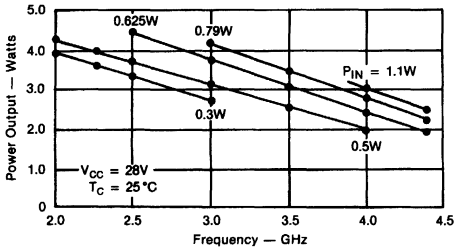
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 2.5mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	15	—	120	—

**DYNAMIC**

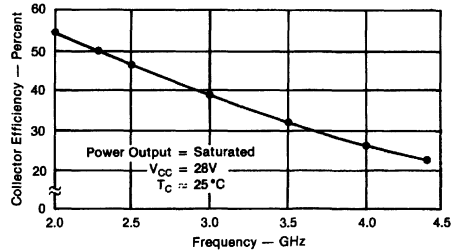
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 4.0\text{ GHz}$	$P_{IN} = 0.79\text{ W}$	$V_{CC} = 28\text{ V}$	2.5	2.7	—	W
$\eta_c$	$f = 4.0\text{ GHz}$	$P_{IN} = 0.79\text{ W}$	$V_{CC} = 28\text{ V}$	25	27	—	%
$G_P$	$f = 4.0\text{ GHz}$	$P_{IN} = 0.79\text{ W}$	$V_{CC} = 28\text{ V}$	5.0	5.3	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	5.0	pF

**TYPICAL PERFORMANCE**

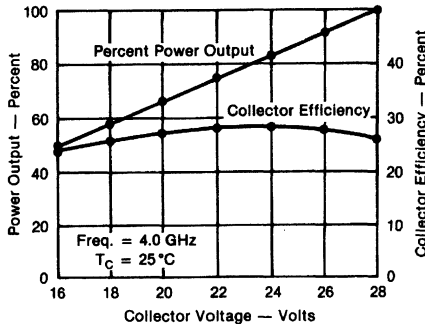
**TYPICAL POWER OUTPUT vs FREQUENCY**



**TYPICAL COLLECTOR EFFICIENCY vs FREQUENCY**

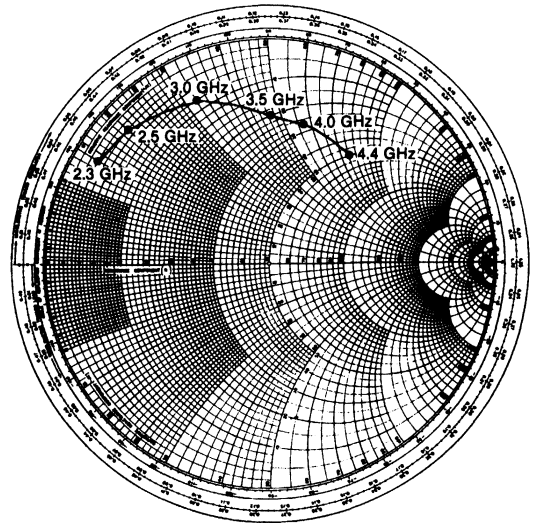
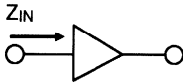


**RELATIVE POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE**



IMPEDANCE DATA

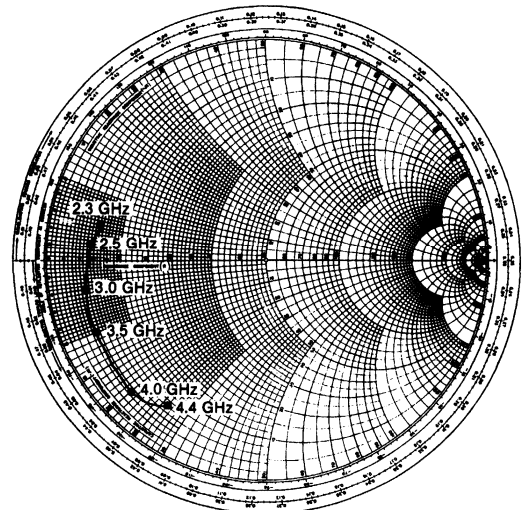
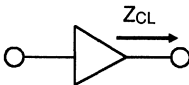
TYPICAL INPUT  
IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
2.3 GHz	3.0 + j 14.0	6.5 + j 5.5
2.5 GHz	4.0 + j 20.0	5.3 + j 2.5
3.0 GHz	8.0 + j 32.0	4.5 - j 4.0
3.5 GHz	20.0 + j 47.0	4.5 - j 10.0
4.0 GHz	27.0 + j 57.0	4.5 - j 20.0
4.4 GHz	50.0 + j 75.0	7.0 - j 26.0

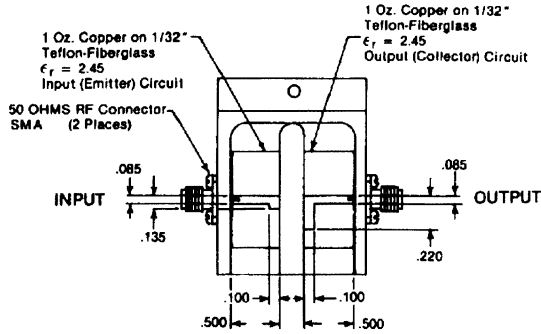
P<sub>OUT</sub> = Saturated  
V<sub>CC</sub> = 28 V  
Normalized to 50 ohms

TYPICAL COLLECTOR  
LOAD IMPEDANCE

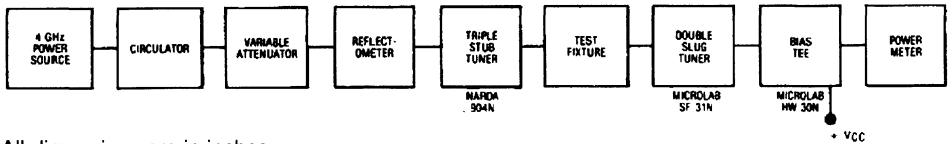


TEST CIRCUIT

Ref.: Dwg. No. C125506B



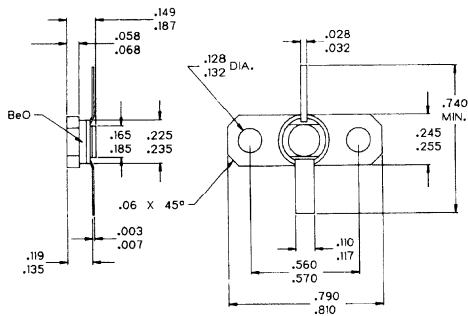
RF Amplifier Power Output Test



All dimensions are in inches.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C

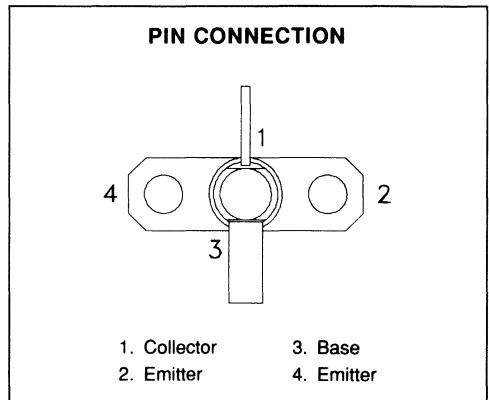
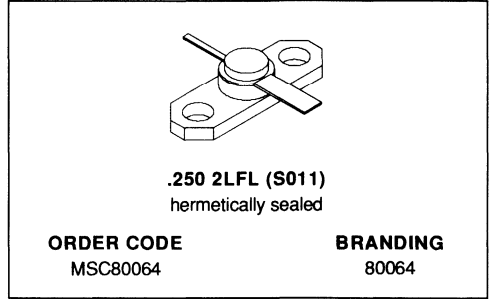


NOTES:  
 1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
 DIMENSIONS IN INCHES.



**RF & MICROWAVE TRANSISTORS  
GENERAL PURPOSE LINEAR APPLICATIONS**

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY 20:1 @ RATED CONDITIONS
- ft 3.2 GHz TYPICAL
- NOISE FIGURE 11 dB @ 3 GHz
- P<sub>OUT</sub> = 20.5 dBm MIN. @ 2 GHz



**DESCRIPTION**

The MSC80064 is a hermetically sealed NPN power transistor featuring a unique matrix structure. This device is specifically designed for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.

**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation (see Safe Area)	—	W
I <sub>C</sub>	Device Bias Current	100	mA
V <sub>CE</sub>	Collector-Emitter Bias Voltage*	20	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	45	°C/W
----------------------	-----------------------------------	----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$	50	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 5\text{mA}$	$I_{\text{B}} = 0\text{mA}$	20	—	—	V
$I_{\text{CEO}}$	$V_{\text{CE}} = 18\text{V}$		—	—	0.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 50\text{mA}$	15	—	120	—

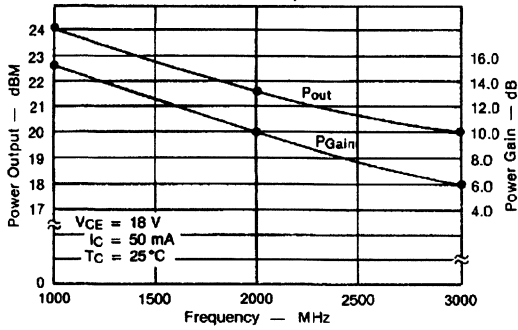
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$G_{\text{P}}^*$	$f = 2.0\text{ GHz}$	$P_{\text{OUT}} = 20.5\text{ dBm}$		9.0	10.0	—	dB
$\Delta G_{\text{P}}^*$	$f = 2.0\text{ GHz}$	$P_{\text{OUT}} = 20.5\text{ dBm}$	$\Delta P_{\text{OUT}} = 10\text{ dB}$	—	—	1	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		—	—	2.5	pF

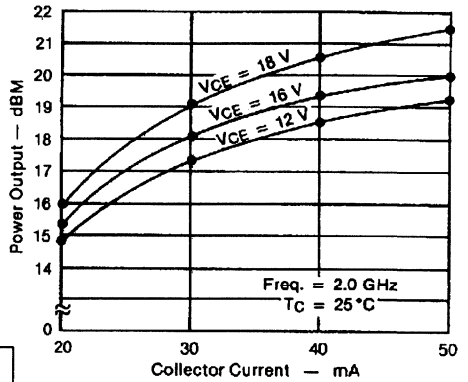
\*Note:  $V_{\text{CE}} = 18\text{ V}$   
 $I_{\text{E}} = 50\text{ mA}$

TYPICAL PERFORMANCE

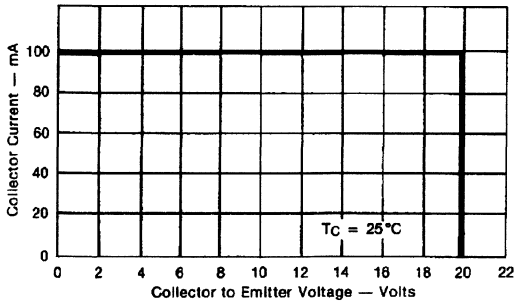
TYPICAL POWER OUTPUT & GAIN @  
1dB COMPRESSION POINT vs  
FREQUENCY



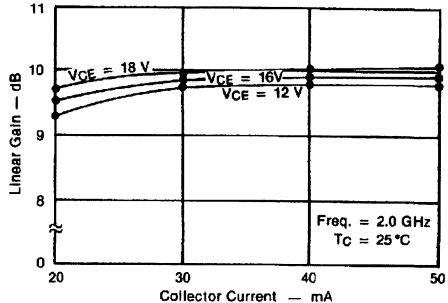
TYPICAL POWER OUTPUT & GAIN @  
1dB COMPRESSION POINT vs  
COLLECTOR EFFICIENCY



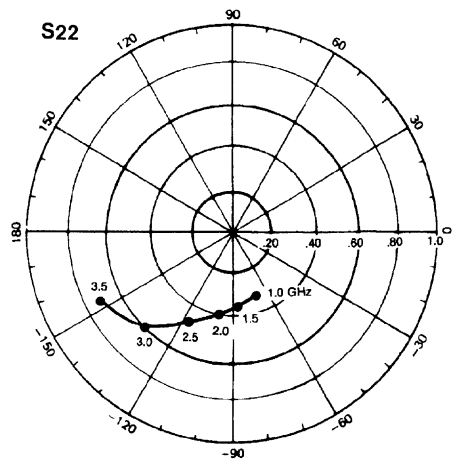
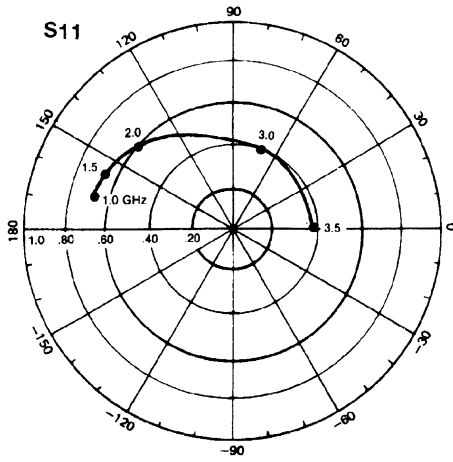
MAXIMUM OPERATING AREA FOR  
FORWARD BIAS OPERATION



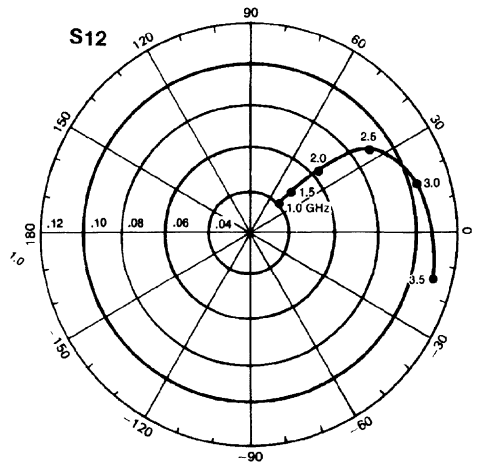
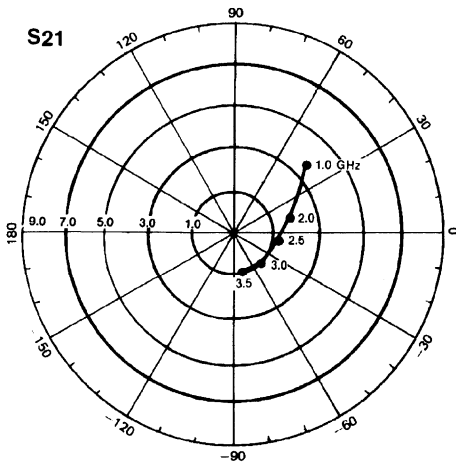
TYPICAL LINEAR GAIN vs  
COLLECTOR CURRENT



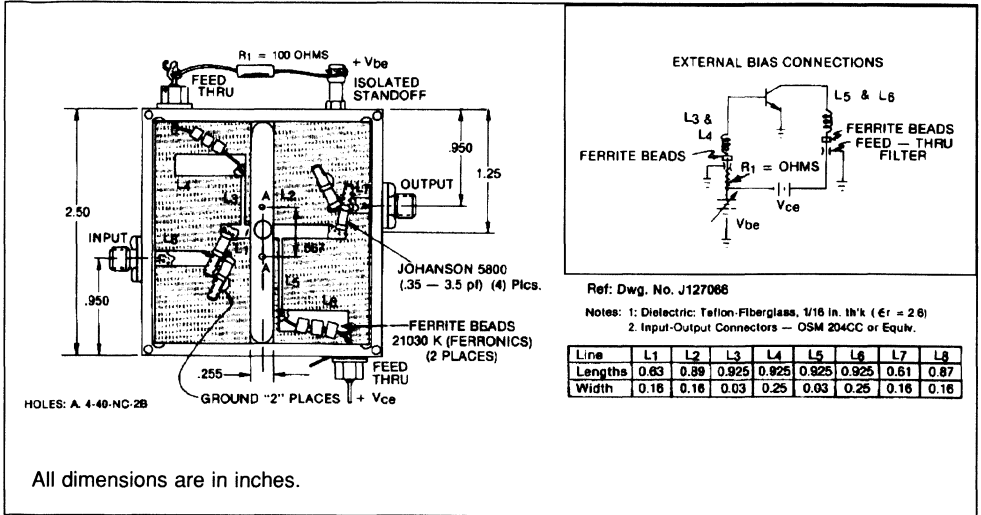
TYPICAL S-PARAMETERS



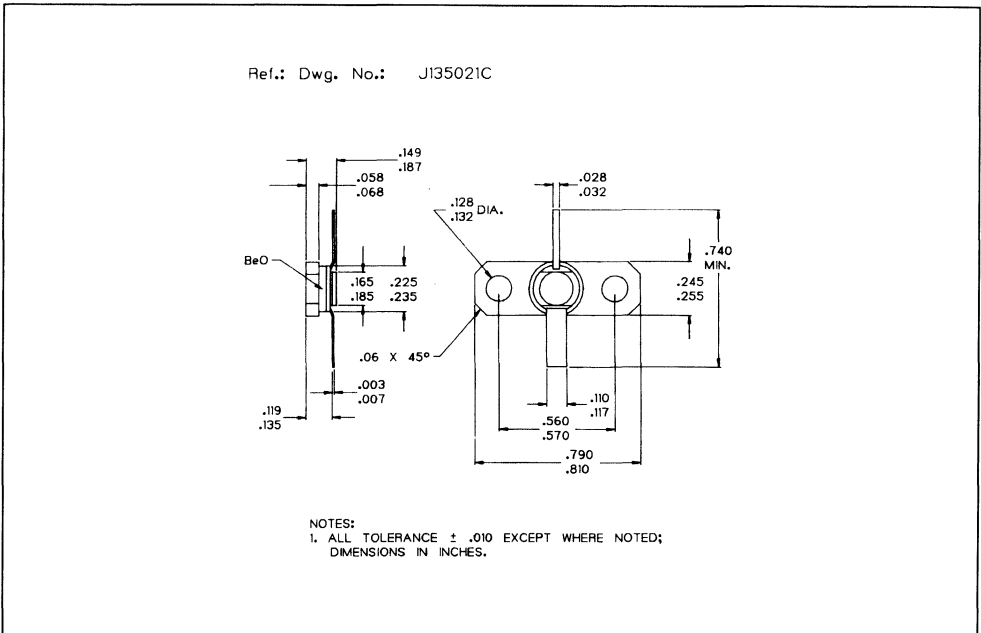
$V_{CE} = 18 \text{ V}$   
 $I_C = \text{mA}$   
 $Z_g = 50 \text{ ohms}$



TEST CIRCUIT



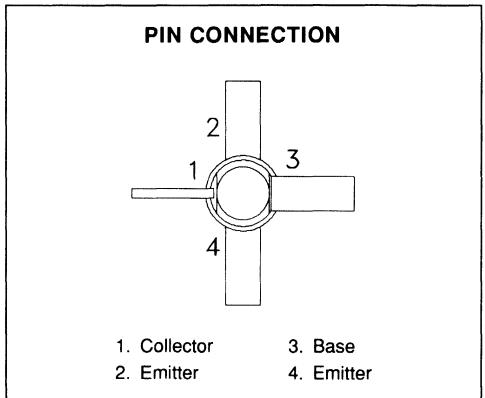
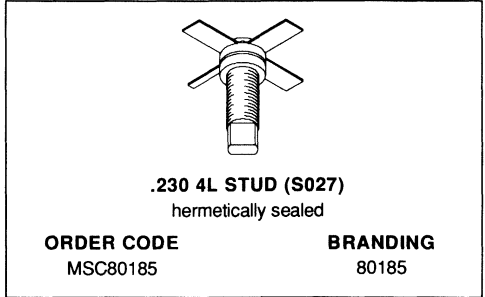
PACKAGE MECHANICAL DATA





**RF & MICROWAVE TRANSISTORS  
GENERAL PURPOSE LINEAR APPLICATIONS**

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY 20:1 @ RATED CONDITIONS
- ft 3.2 GHz TYPICAL
- NOISE FIGURE 12.0 dB @ 2 GHz
- P<sub>OUT</sub> = 28 dBm MIN. @ 2.0 GHz



**DESCRIPTION**

The MSC80185 is a hermetically sealed NPN power transistor featuring a unique matrix structure. This device is specifically designed for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.

**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation (see Safe Area)	—	W
I <sub>C</sub>	Device Bias Current	300	mA
V <sub>CE</sub>	Collector-Emitter Bias Voltage*	20	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	35	°C/W
----------------------	-----------------------------------	----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	20	—	—	V
$I_{CEO}$	$V_{CE} = 18V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

**DYNAMIC**

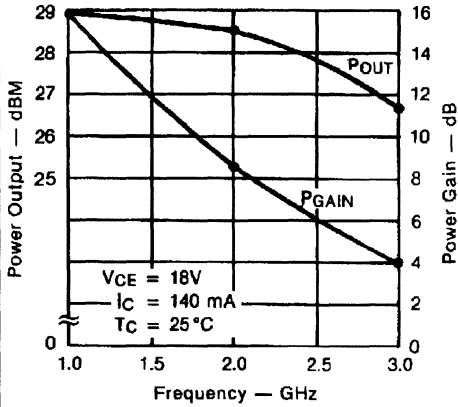
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$G_P^*$	$f = 2.0 GHz$	$P_{OUT} = 28 dBm$	7.5	8.5	—	dB
$\Delta G_P^*$	$f = 2.0 GHz$	$P_{OUT} = 28 dBm$	—	—	1	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$	—	—	3.0	pF

\* Note:  $V_{CE} = 18V$   
 $I_C = 140mA$

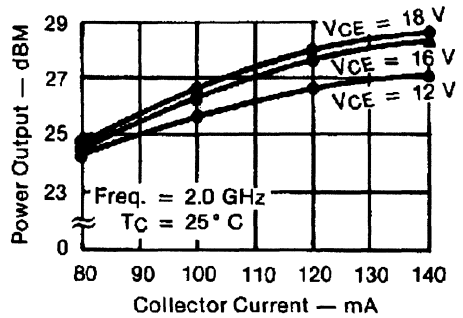


TYPICAL PERFORMANCE

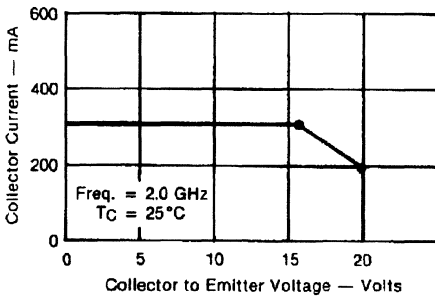
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs FREQUENCY



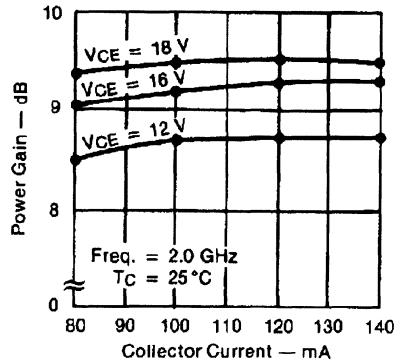
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



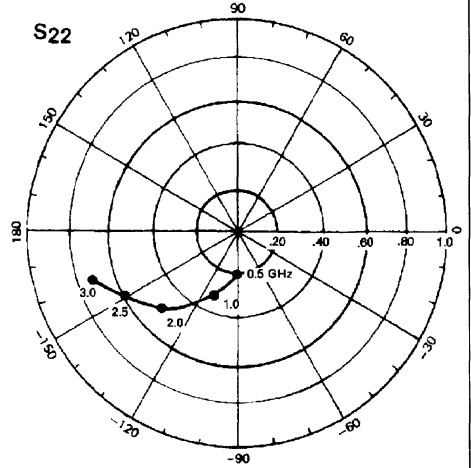
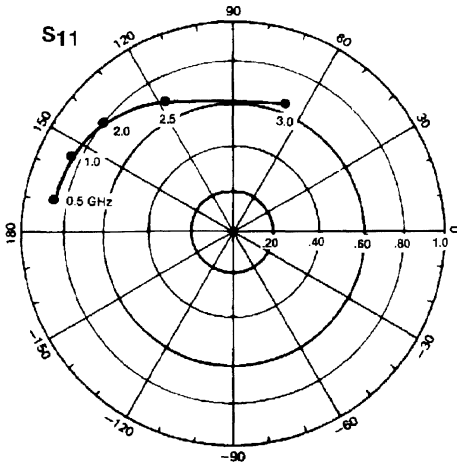
MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION



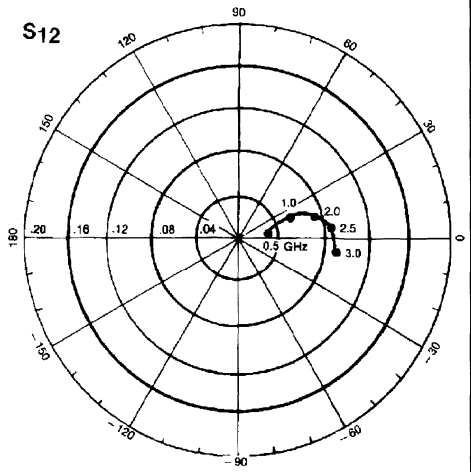
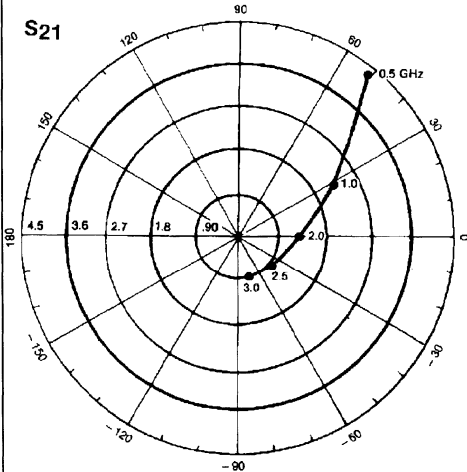
TYPICAL LINEAR GAIN vs COLLECTOR CURRENT



TYPICAL S-PARAMETERS



V<sub>CE</sub> = 18 V  
I<sub>C</sub> = 140 mA  
Z<sub>g</sub> = 50 ohms

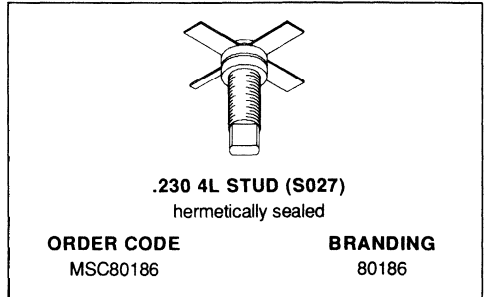






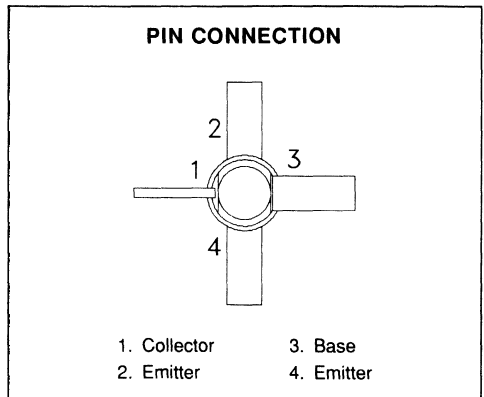
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY 15:1 @ RATED CONDITIONS
- ft 3.2 GHz TYPICAL
- NOISE FIGURE 12.5 dB @ 2 GHz
- P<sub>OUT</sub> = 30.0 dBm MIN.



### DESCRIPTION

The MSC80185 is a hermetically sealed NPN power transistor featuring a unique matrix structure. This device is specifically designed for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation (see Safe Area)	—	W
I <sub>C</sub>	Device Bias Current	500	mA
V <sub>CE</sub>	Collector-Emitter Bias Voltage*	20	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	17	°C/W
----------------------	-----------------------------------	----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	20	—	—	V
$I_{CEO}$	$V_{CE} = 18V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = mA$	15	—	120	—

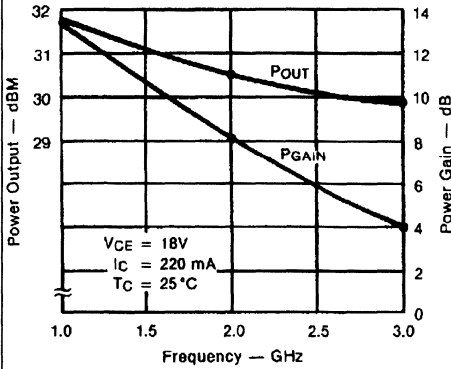
**DYNAMIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$G_P^*$	$f = 2.0 GHz$	$P_{OUT} = 30.0 dBm$	7.0	9.0	—	dB
$\Delta G_P^*$	$f = 2.0 GHz$	$P_{OUT} = 30.0 dBm$ $\Delta P_{OUT} = 10 dB$	—	—	1	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$	—	—	5.0	pF

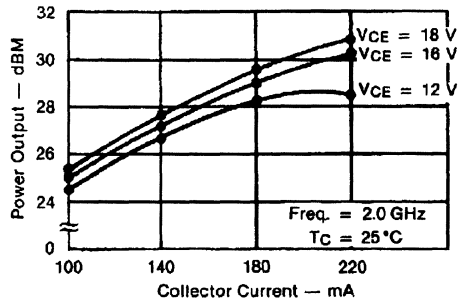
\* Note:  $V_{CE} = 18V$   
 $I_C = 220mA$

TYPICAL PERFORMANCE

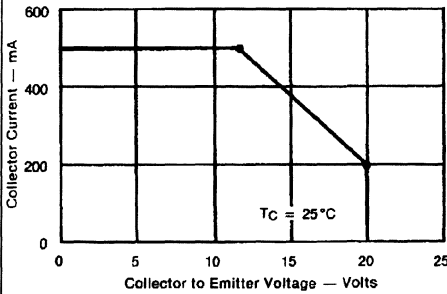
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs FREQUENCY



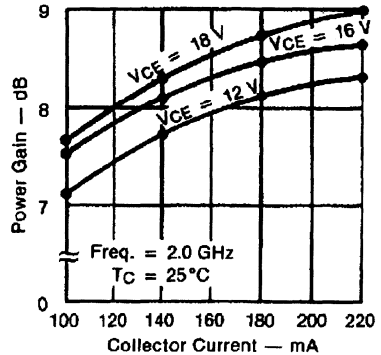
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



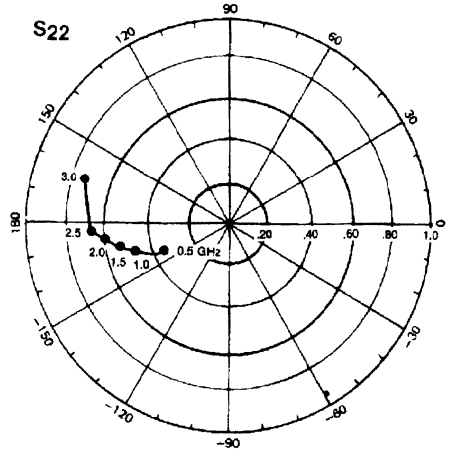
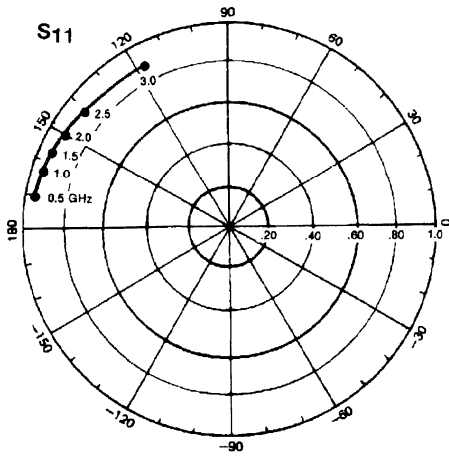
MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION



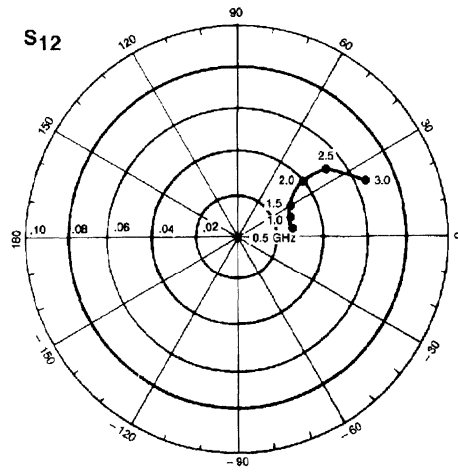
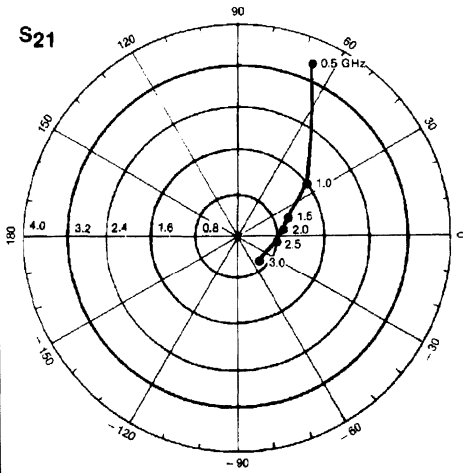
TYPICAL LINEAR GAIN vs COLLECTOR CURRENT



TYPICAL S-PARAMETERS



V<sub>CE</sub> = 18 V  
I<sub>C</sub> = 220 mA  
Z<sub>g</sub> = 50 ohms



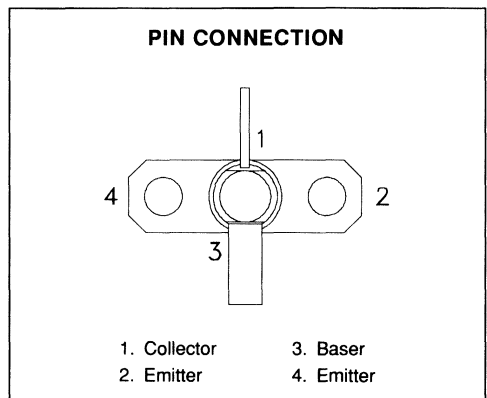
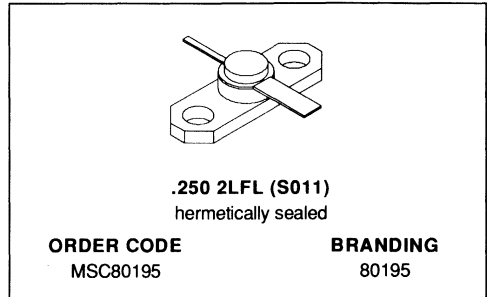






## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY 20:1 @ RATED CONDITIONS
- ft 3.2 GHz TYPICAL
- NOISE FIGURE 12.0 dB @ 2 GHz
- P<sub>OUT</sub> = 28 dBm MIN. @ 2.0 GHz



### DESCRIPTION

The MSC80195 is a hermetically sealed NPN power transistor featuring a unique matrix structure. This device is specifically designed for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation (see Safe Area)	—	W
I <sub>C</sub>	Device Bias Current	300	mA
V <sub>CE</sub>	Collector-Emitter Bias Voltage*	20	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	35	°C/W
----------------------	-----------------------------------	----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$	50	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 5\text{mA}$	$I_{\text{B}} = 0\text{mA}$	20	—	—	V
$I_{\text{CEO}}$	$V_{\text{CE}} = 18\text{V}$		—	—	0.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$	15	—	120	—

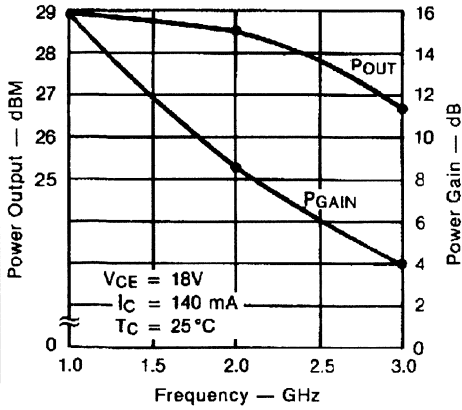
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$G_{\text{P}}^*$	$f = 2.0\text{ GHz}$	$P_{\text{OUT}} = 28\text{ dBm}$	—	—	1		dB
$\Delta G_{\text{P}}^*$	$f = 2.0\text{ GHz}$	$P_{\text{OUT}} = 28\text{ dBm}$	$\Delta P_{\text{OUT}} = 10\text{ dB}$	7.5	8.5	—	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		—	—	3.0	pF

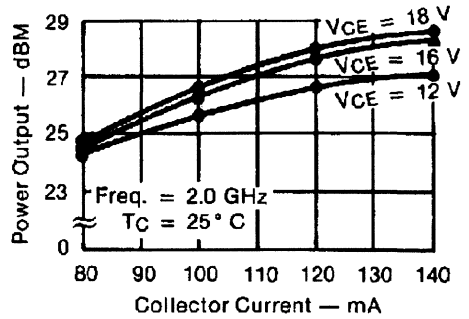
\* Note:  $V_{\text{CE}} = 18\text{ V}$   
 $I_{\text{C}} = 140\text{mA}$

TYPICAL PERFORMANCE

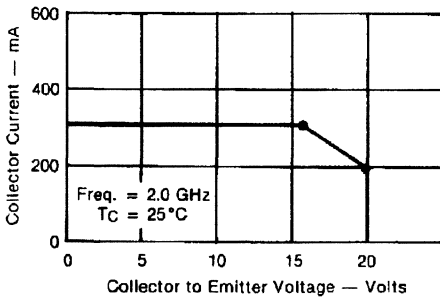
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs FREQUENCY



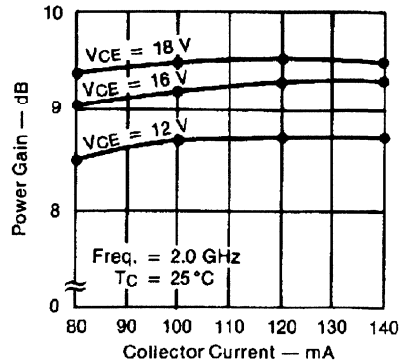
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



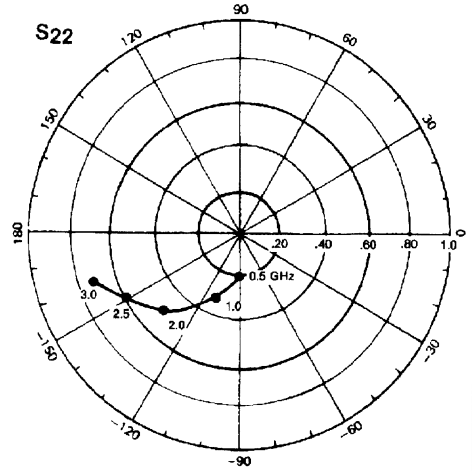
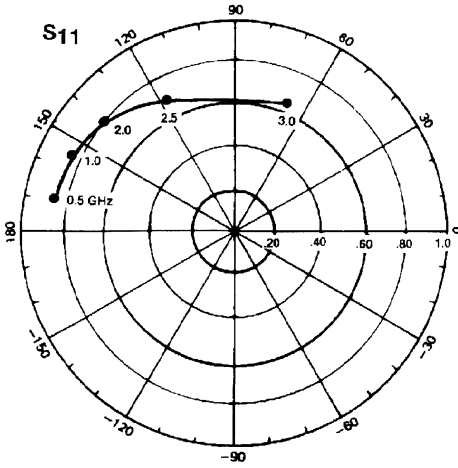
MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION



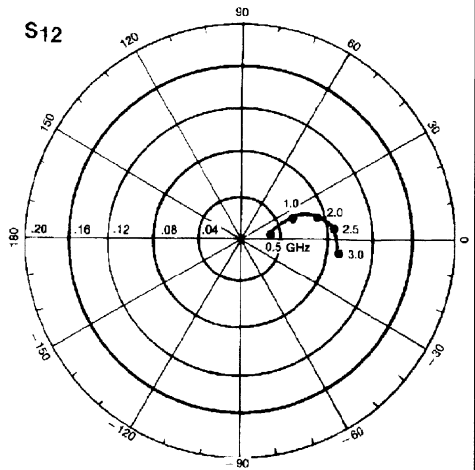
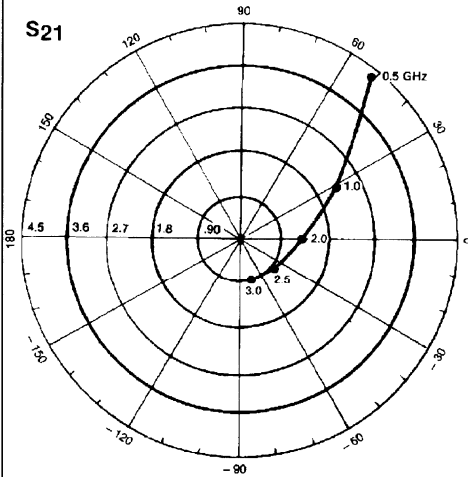
TYPICAL LINEAR GAIN vs COLLECTOR CURRENT



TYPICAL S-PARAMETERS

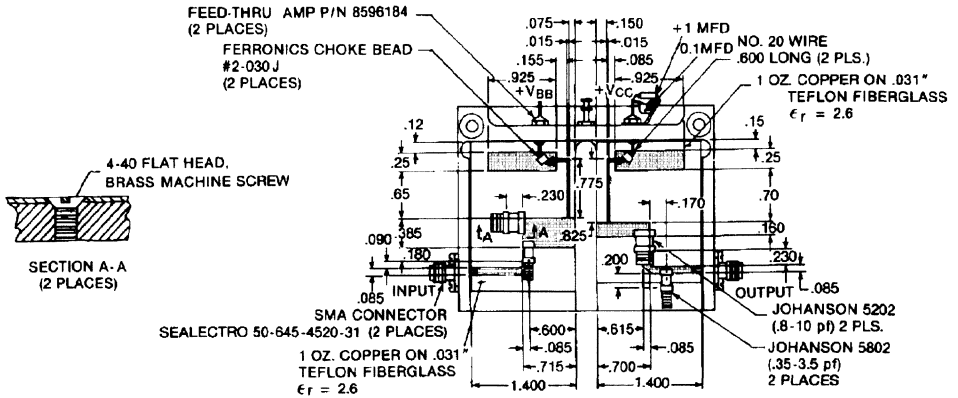


V<sub>CE</sub> = 18 V  
I<sub>C</sub> = 140mA  
Z<sub>g</sub> = 50 ohms



TEST CIRCUIT

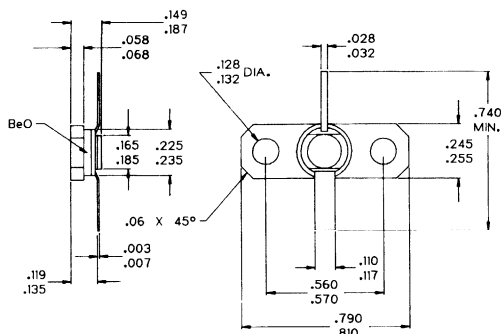
Ref.: Dwg. No. C127304A



All dimensions are in inches.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C



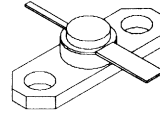
NOTES:  
 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
 DIMENSIONS IN INCHES.





## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY 15:1 @ RATED CONDITIONS
- ft 3.2 GHz TYPICAL
- NOISE FIGURE 12.5 dB @ 2 GHz
- P<sub>OUT</sub> = 30.0 dBm MIN.



**.250 2LFL (S011)**  
hermetically sealed

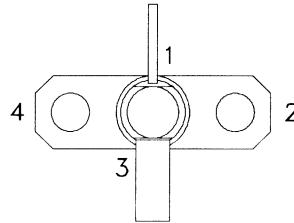
**ORDER CODE**  
MSC80196

**BRANDING**  
80196

### DESCRIPTION

The MSC80196 is a hermetically sealed NPN power transistor featuring a unique matrix structure. This device is specifically designed for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.

### PIN CONNECTION



- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation (see Safe Area)	—	W
I <sub>C</sub>	Device Bias Current	500	mA
V <sub>CE</sub>	Collector-Emitter Bias Voltage*	20	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	17	°C/W
----------------------	-----------------------------------	----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	20	—	—	V
$I_{CEO}$	$V_{CE} = 18V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = mA$	15	—	120	—

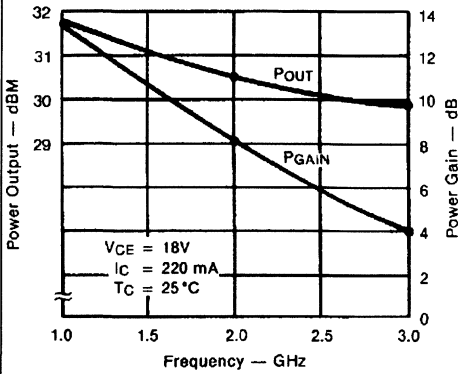
**DYNAMIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$G_P^*$	$f = 2.0 GHz$	$P_{OUT} = 30.0 dBm$	7.0	9.0	—	dB
$\Delta G_P^*$	$f = 2.0 GHz$	$P_{OUT} = 30.0 dBm$	$\Delta P_{OUT} = 10 dB$		1	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$	—	—	5.0	pF

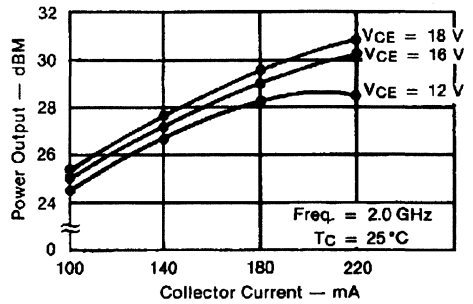
\* Note:  $V_{CE} = 18V$   
 $I_C = 220mA$

TYPICAL PERFORMANCE

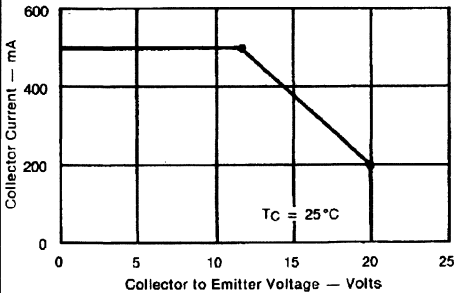
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs FREQUENCY



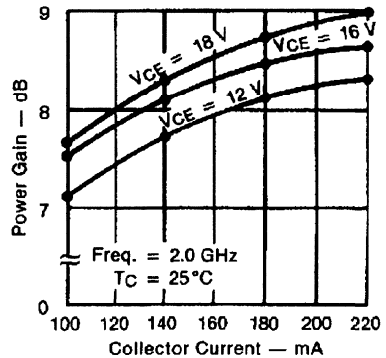
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



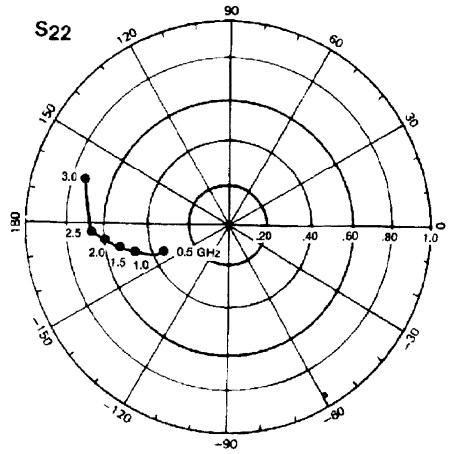
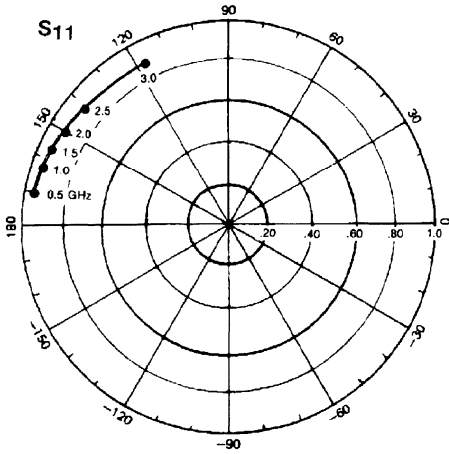
MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION



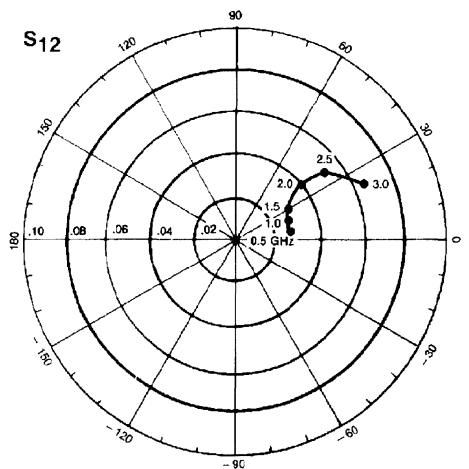
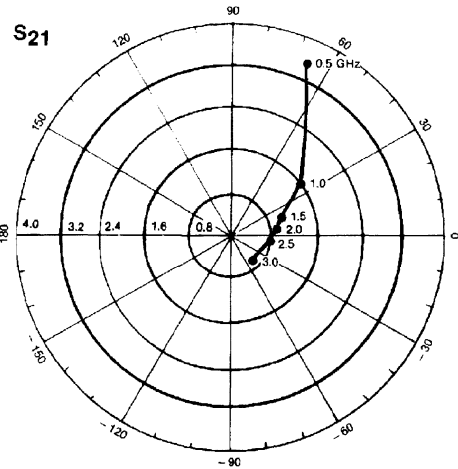
TYPICAL LINEAR GAIN vs COLLECTOR CURRENT



TYPICAL S-PARAMETERS



V<sub>CE</sub> = 18 V  
I<sub>C</sub> = 220 mA  
Z<sub>g</sub> = 50 ohms

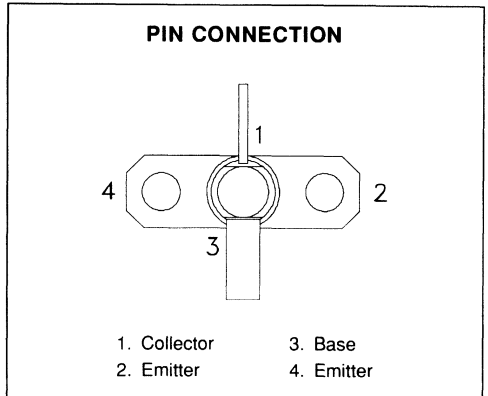
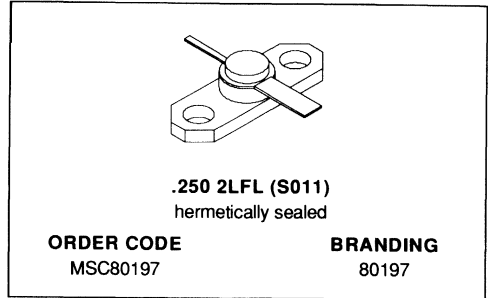






## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY 15:1 @ RATED CONDITIONS
- ft 3.2 GHz TYPICAL
- NOISE FIGURE 12.5 dB @ 2 GHz
- P<sub>OUT</sub> = 31.7 dBm MIN. @ 2.0 GHz



### DESCRIPTION

The MSC80197 is a hermetically sealed NPN power transistor featuring a unique matrix structure. This device is specifically designed for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation (see Safe Area)	—	W
I <sub>C</sub>	Device Bias Current	700	mA
V <sub>CE</sub>	Collector-Emitter Bias Voltage*	20	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	8.5	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	20	—	—	V
$I_{CEO}$	$V_{CE} = 18V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	15	—	120	—

**DYNAMIC**

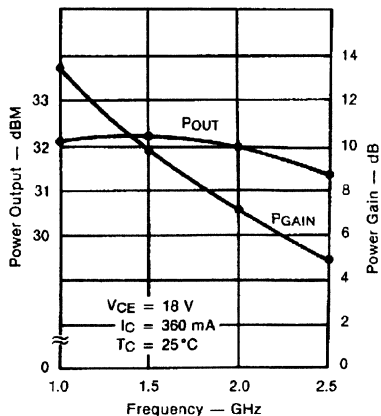
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$G_P^*$	$f = 2.0 GHz$	$P_{OUT} = 31.7 dBm$	6.0	7.0	—	dB
$\Delta G_P^*$	$f = 2.0 GHz$	$P_{OUT} = 31.7 dBm$ $\Delta P_{OUT} = 10 dB$	—	—	1	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$	—	—	7.0	pF

\* Note:  $V_{CE} = 18 V$   
 $I_C = 360 mA$

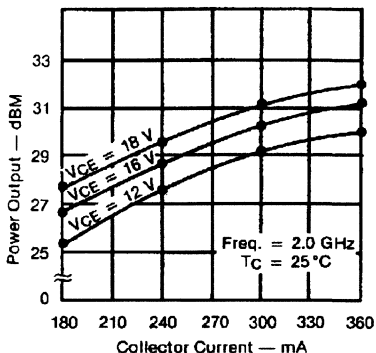


TYPICAL PERFORMANCE

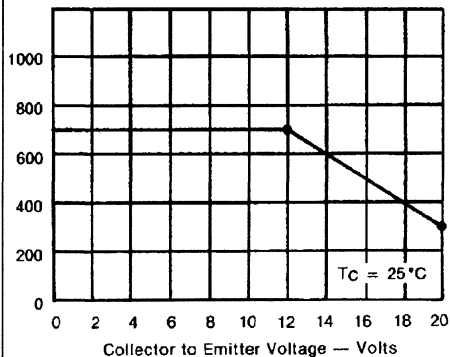
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs FREQUENCY



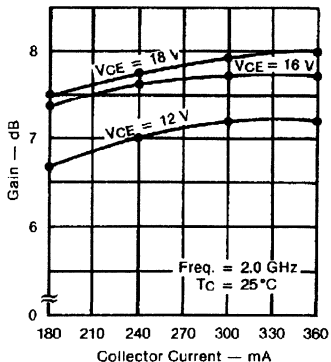
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



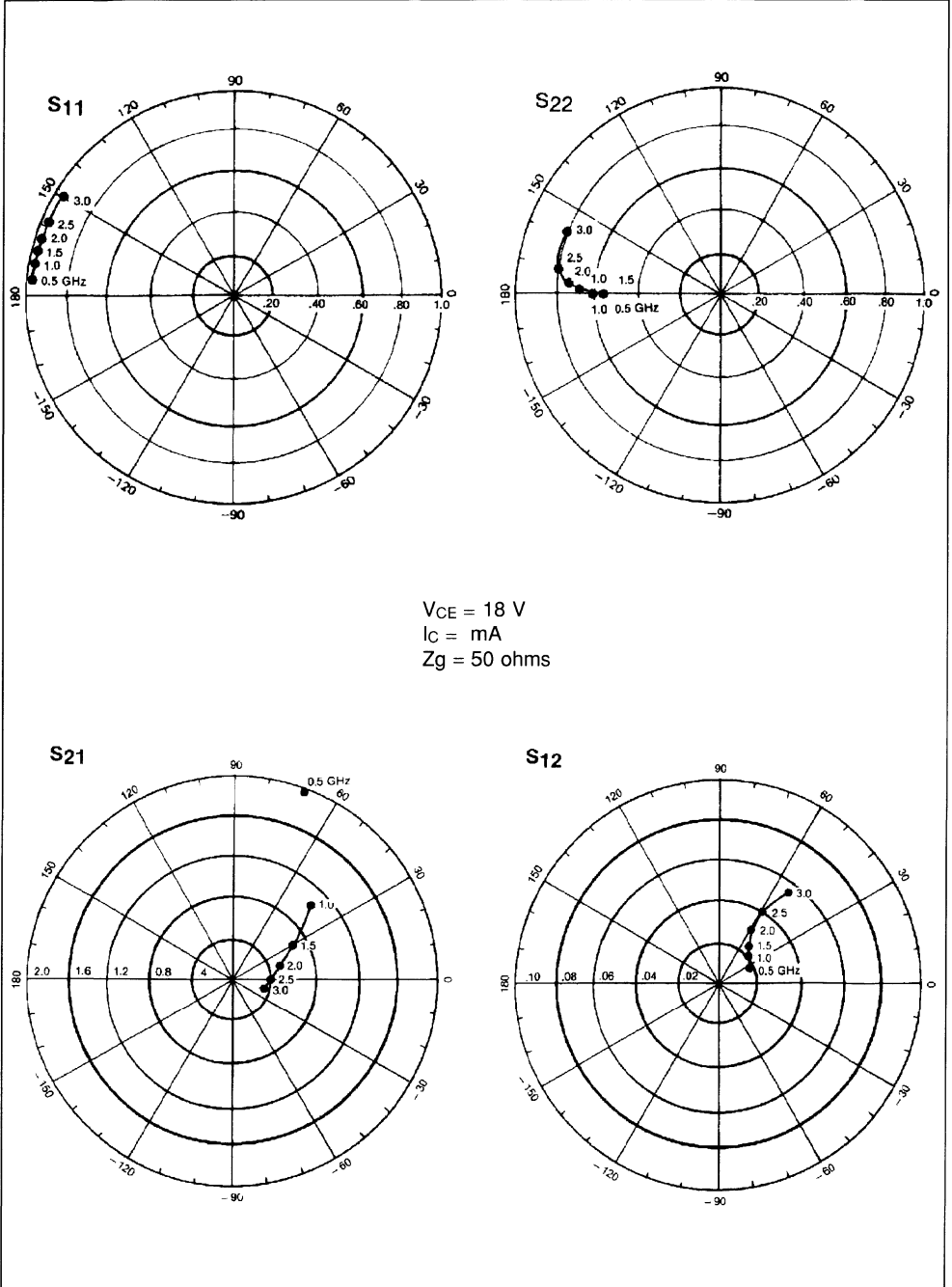
MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION



TYPICAL LINEAR GAIN vs COLLECTOR CURRENT



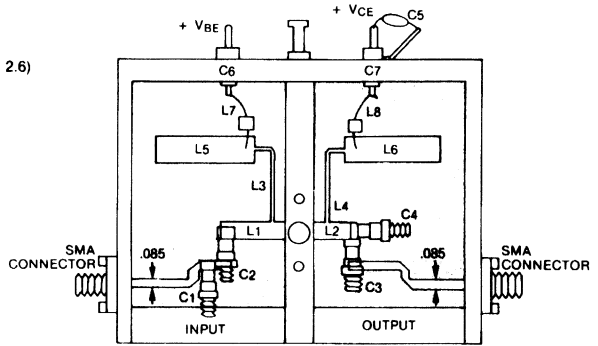
TYPICAL S-PARAMETERS



TEST CIRCUIT

Ref.: Dwg. No. C127271

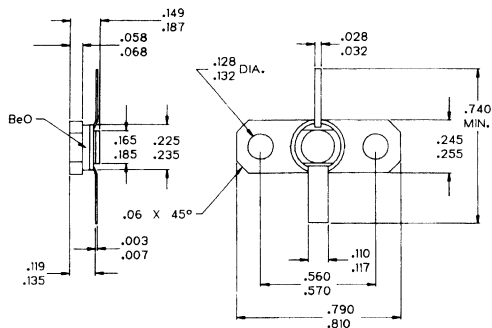
- Board Material 1/32" Teflon — Fiberglass ( $\epsilon_r = 2.6$ )  
 C1, C2, C3, C4, 0.35 to 3.5 pf Johanson #5800  
 C5, 0.1  $\mu$ f Disk Capacitor  
 C6, C7, Feadthru Filter SCI 712 — 022 (1500 pf)  
 or AMP P/N 8596184  
 L1, .160 Wide, .590 Long  
 L2, .160 Wide, .425 Long  
 L3, L4, .020 Wide, .825 Long  
 L5, L6, .250 Wide, .900 Long  
 L7, L8, #20 A.W.G. Tinned Copper, .600 Long,  
 Ferronics Chokebead #21 - 030 - J



Frequency 2.0 GHz  
 All dimensions are in inches.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C

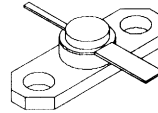


NOTES:  
 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
 DIMENSIONS IN INCHES.



## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY 20:1 @ RATED CONDITIONS
- ft 3.2 GHz TYPICAL
- NOISE FIGURE 11.0 dB @ 2 GHz
- P<sub>OUT</sub> = 28 dBm MIN. @ 2.0 GHz



**.250 2LFL (S011)**  
hermetically sealed

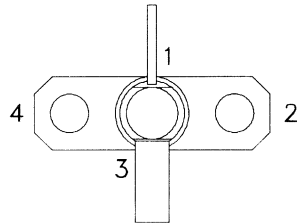
**ORDER CODE**  
MSC80264

**BRANDING**  
80264

### DESCRIPTION

The MSC80264 is a hermetically sealed NPN power transistor featuring a unique matrix structure. This device is specifically designed for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point at frequencies from 1.0 - 4.0 GHz.

### PIN CONNECTION



- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation (see Safe Area)	—	W
I <sub>C</sub>	Device Bias Current	67	mA
V <sub>CE</sub>	Collector-Emitter Bias Voltage*	20	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	45	°C/W
----------------------	-----------------------------------	----	------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	15	—	—	V
$I_{CEO}$	$V_{CE} = 12V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

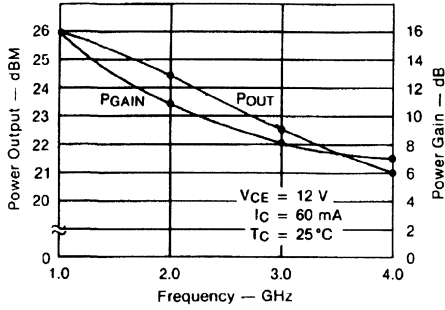
**DYNAMIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$G_P^*$	$f = 4.0 GHz$	$P_{OUT} = 20 dBm$	6.0	7.0	—	dB
$\Delta G_P^*$	$f = 4.0 GHz$	$P_{OUT} = 20 dBm$	—	—	1	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$	—	—	2.5	pF

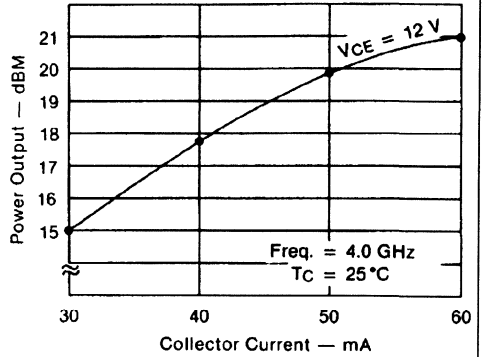
\* Note:  $V_{CE} = 12V$   
 $I_C = 60mA$

TYPICAL PERFORMANCE

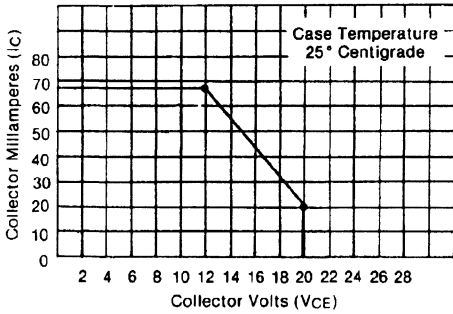
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs FREQUENCY



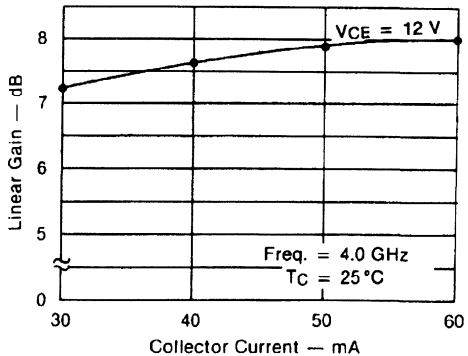
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



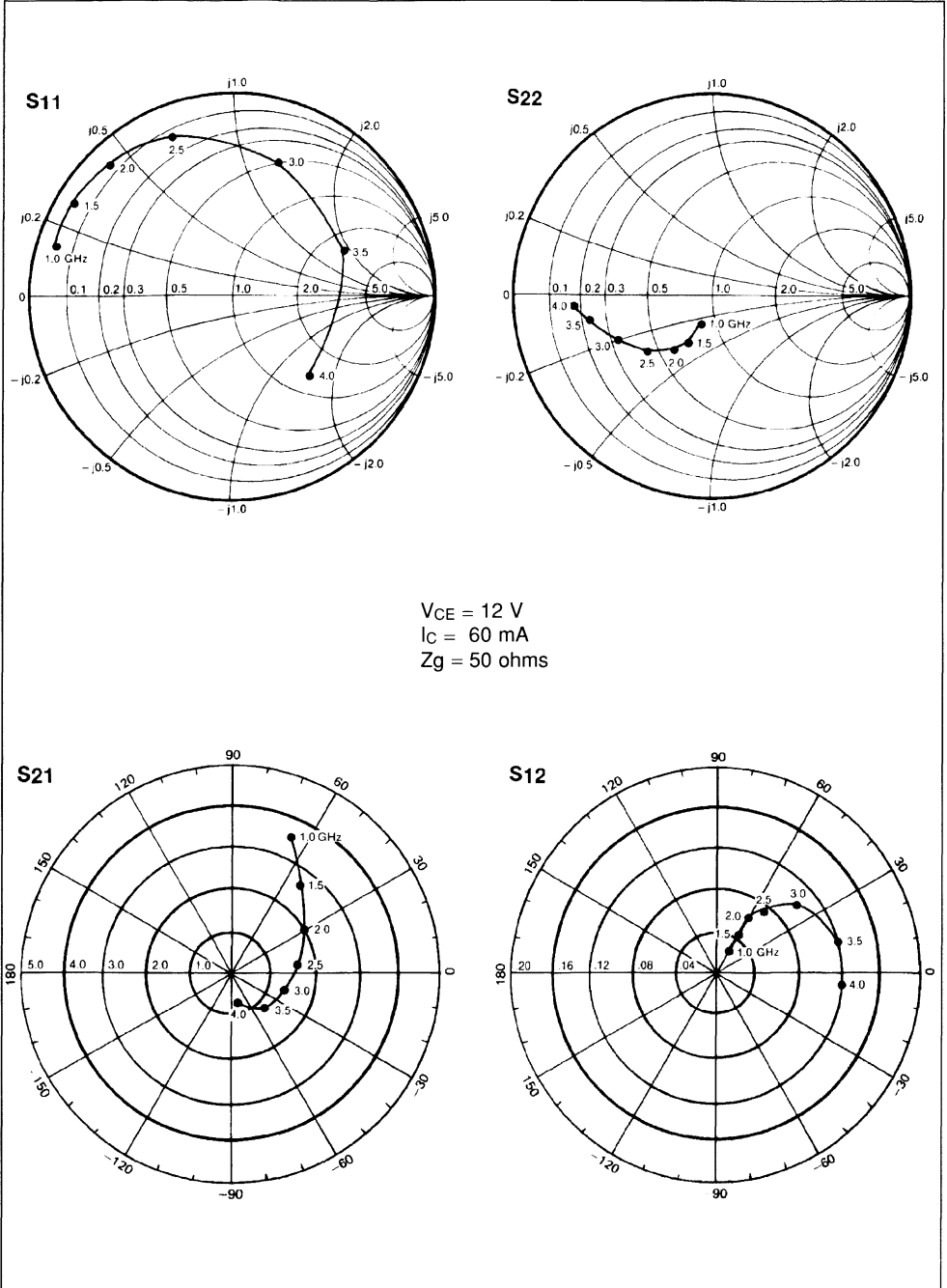
MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION



TYPICAL LINEAR GAIN vs COLLECTOR CURRENT

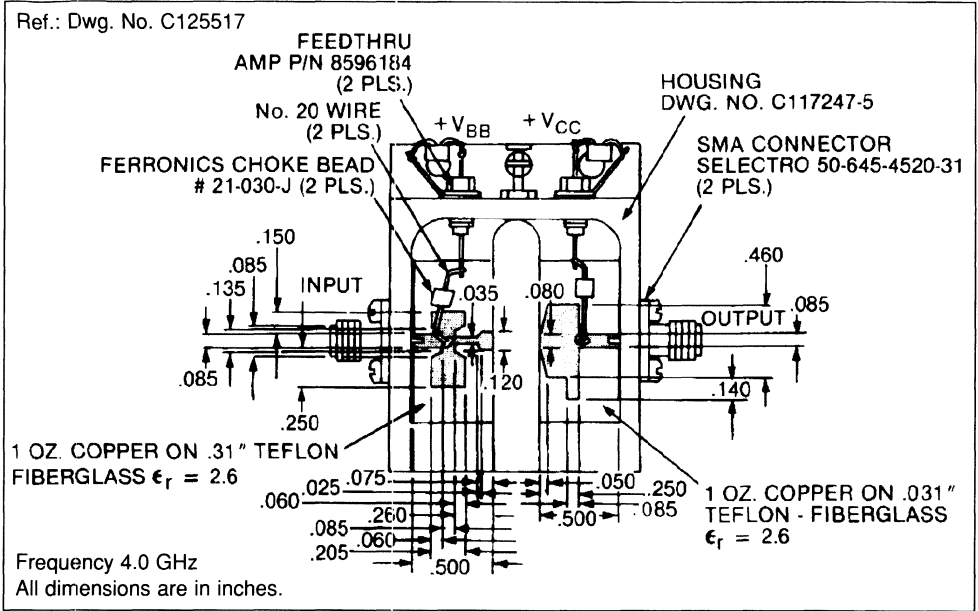


TYPICAL S-PARAMETERS

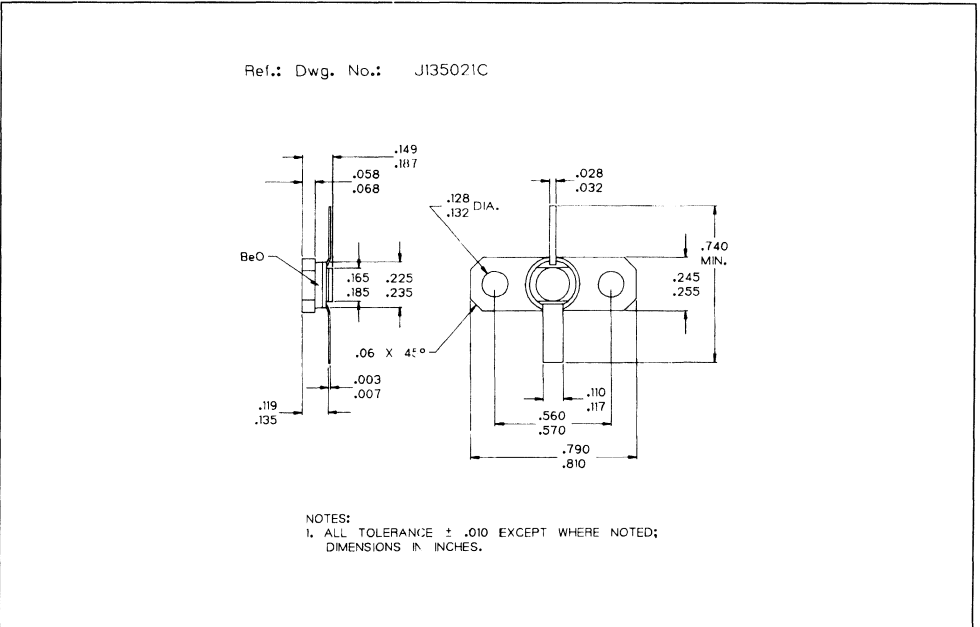




**TEST CIRCUIT**



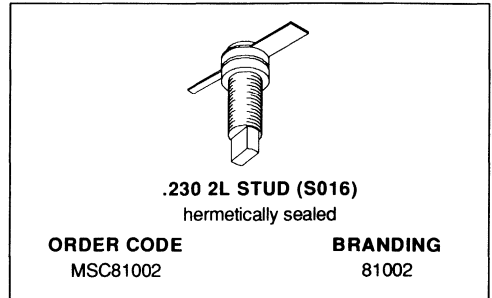
**PACKAGE MECHANICAL DATA**





## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

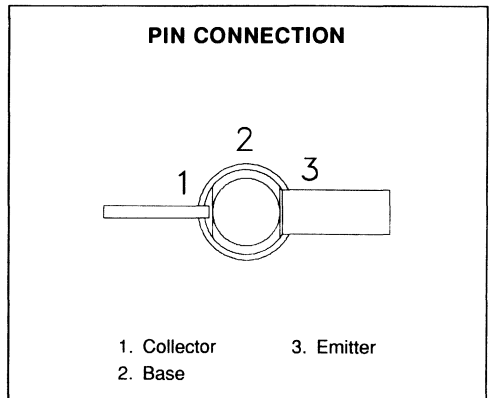
- EMITTER BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC<sup>®</sup> PACKAGE
- $P_{OUT} = 2.0$  W MIN. WITH 10 dB GAIN @ 1 GHz



### DESCRIPTION

The MSC81002 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone, emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions.

The MSC81002 was designed for Class C amplifier applications in the 0.4 - 1.2 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 75^{\circ}C$ )	6.25	W
$I_C$	Device Current*	200	mA
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	20	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

# MSC81002

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

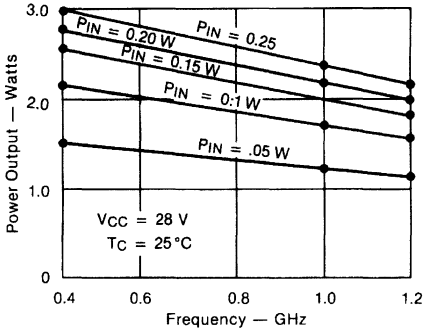
### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

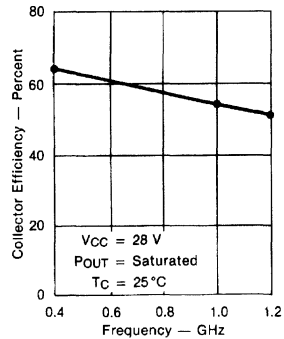
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.0 GHz$	$P_{IN} = 0.2 W$	$V_{CC} = 28 V$	2.0	2.2	—	W
$\eta_C$	$f = 1.0 GHz$	$P_{IN} = 0.2 W$	$V_{CC} = 28 V$	50	55	—	%
$G_P$	$f = 1.0 GHz$	$P_{IN} = 0.2 W$	$V_{CC} = 28 V$	10	10.4	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	—	3.2	pF

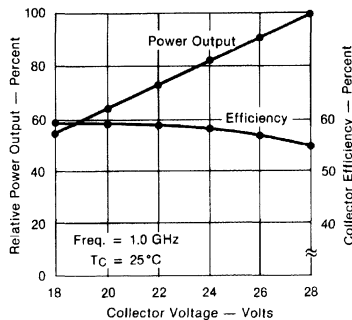
### TYPICAL PERFORMANCE POWER OUTPUT vs FREQUENCY



### COLLECTOR EFFICIENCY vs FREQUENCY

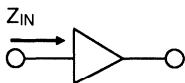


### RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE

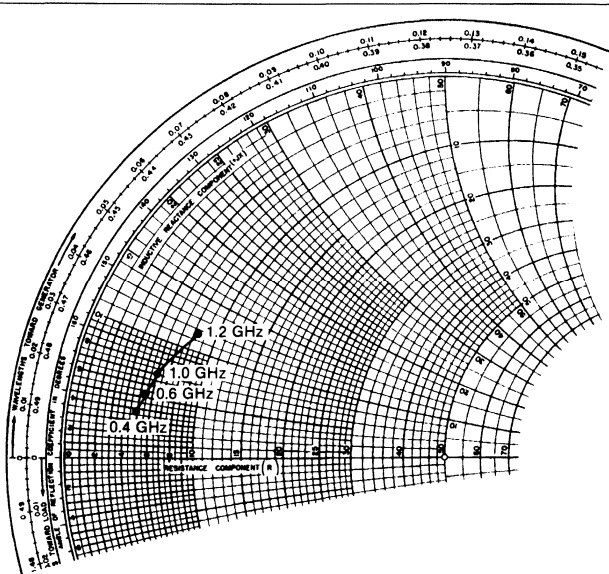


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

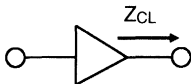


$P_{IN} = 0.2\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms

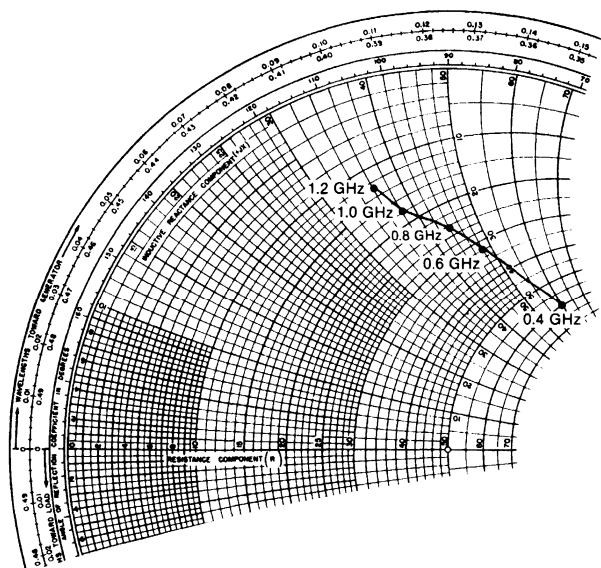


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
0.4 GHz	$4.8 + j 3.7$	$60.0 + j 60.0$
0.6 GHz	$5.4 + j 5.3$	$32.0 + j 48.0$
1.0 GHz	$6.0 + j 7.0$	$18.0 + j 38.0$
1.2 GHz	$8.2 + j 11.6$	$12.8 + j 36.0$

TYPICAL COLLECTOR LOAD IMPEDANCE

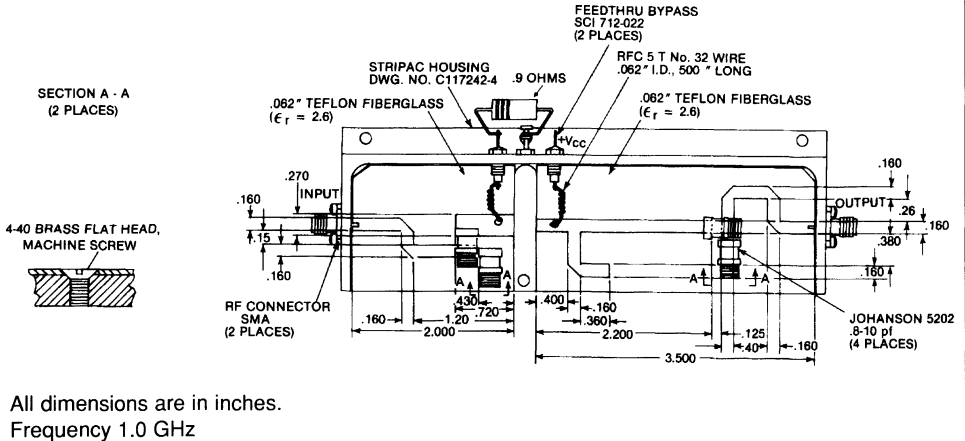


$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms



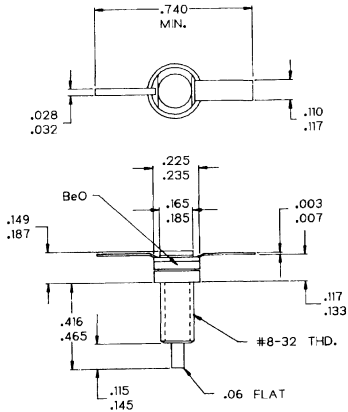
TEST CIRCUIT

Ref.: Dwg. No. C127317



PACKAGE MECHANICAL DATA

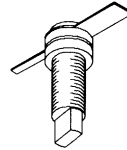
Ref.: Dwg. No.: J135022C



NOTES:  
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

**RF & MICROWAVE TRANSISTORS  
 GENERAL PURPOSE AMPLIFIER APPLICATIONS**

- EMITTER BALLASTED
- REFRACTORY/GOLD METALLIZATION
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 5.0$  W MIN. WITH 10 dB GAIN @ 1 GHz



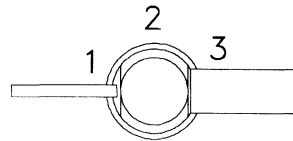
**.230 2L STUD (S016)**  
 hermetically sealed

**ORDER CODE**  
 MSC81005

**BRANDING**  
 81005

**DESCRIPTION**

The MSC81005 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC81005 is designed for Class C amplifier applications in the 0.4 - 1.2 GHz frequency range.

**PIN CONNECTION**


1. Collector  
 2. Base

3. Emitter

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	18.75	W
$I_C$	Device Current*	600	mA
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	8.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

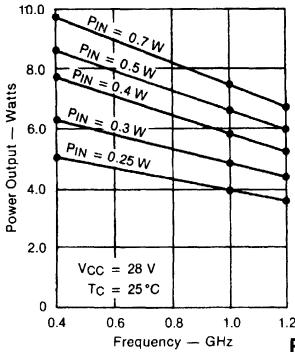
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_c = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_c = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_c = 200mA$	15	—	120	—

**DYNAMIC**

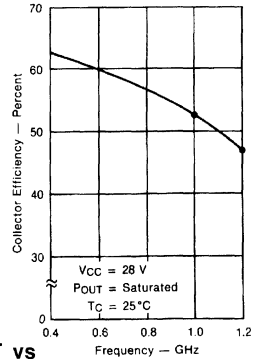
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.0 GHz$	$P_{IN} = 0.5 W$	$V_{CC} = 28 V$	5.0	6.6	—	W
$\eta_c$	$f = 1.0 GHz$	$P_{IN} = 0.5 W$	$V_{CC} = 28 V$	50	52	—	%
GP	$f = 1.0 GHz$	$P_{IN} = 0.5 W$	$V_{CC} = 28 V$	10	11.2	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	—	6.5	pF

**TYPICAL PERFORMANCE**

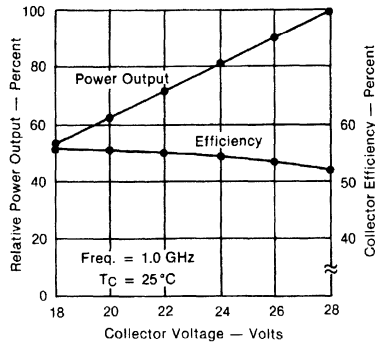
**POWER OUTPUT vs FREQUENCY**



**COLLECTOR EFFICIENCY vs FREQUENCY**



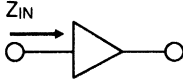
**RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE**



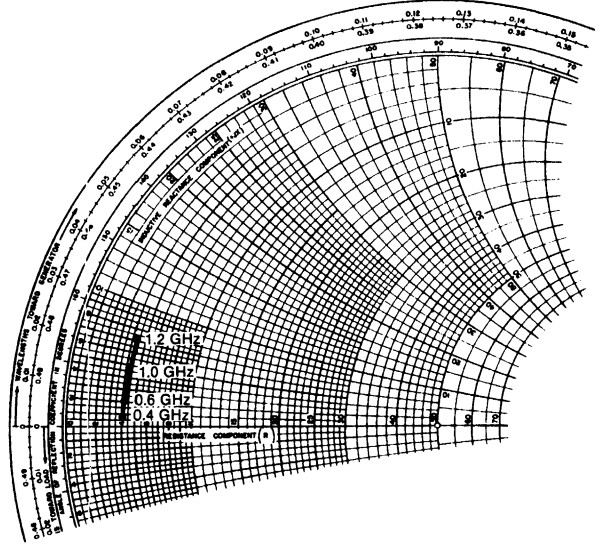


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

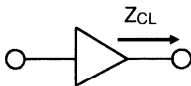


$P_{IN} = 0.5\text{ W}$   
 $V_{CC} = 35\text{ V}$   
 Normalized to 50 ohms

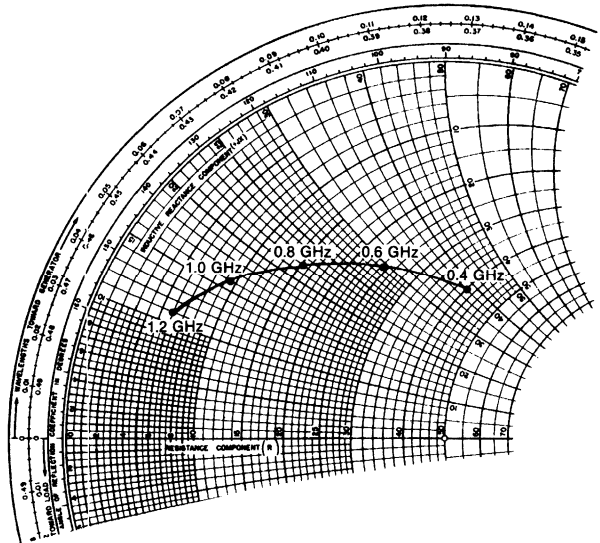


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
0.4 GHz	$4.0 + j 0.8$	$40.0 + j 38.0$
0.6 GHz	$4.1 + j 2.0$	$24.0 + j 29.5$
0.8 GHz	$4.2 + j 3.2$	$15.0 + j 22.0$
1.0 GHz	$4.3 + j 4.5$	$9.4 + j 16.0$
1.2 GHz	$4.4 + j 7.1$	$6.0 + j 11.0$

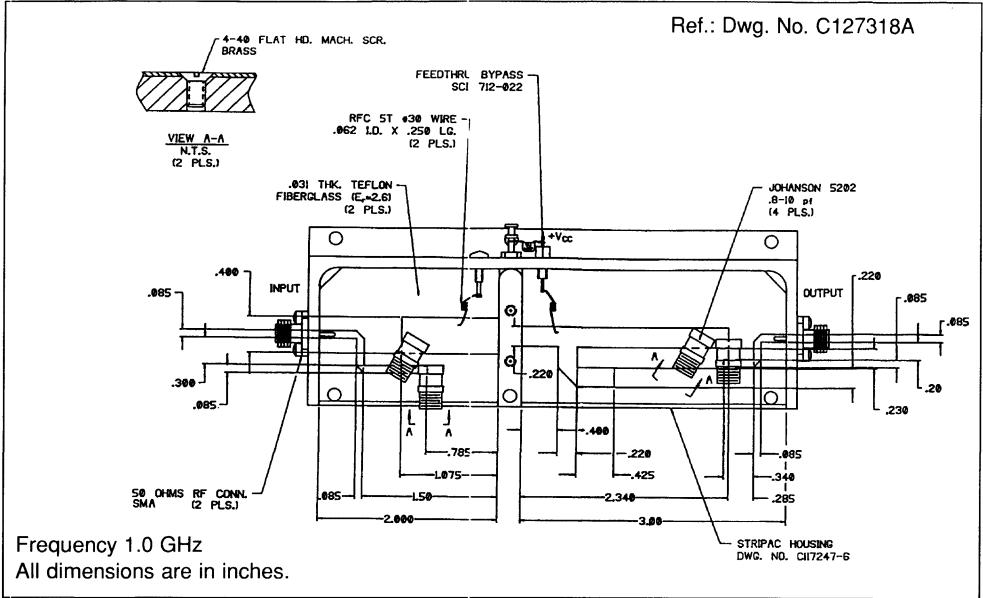
TYPICAL COLLECTOR LOAD IMPEDANCE



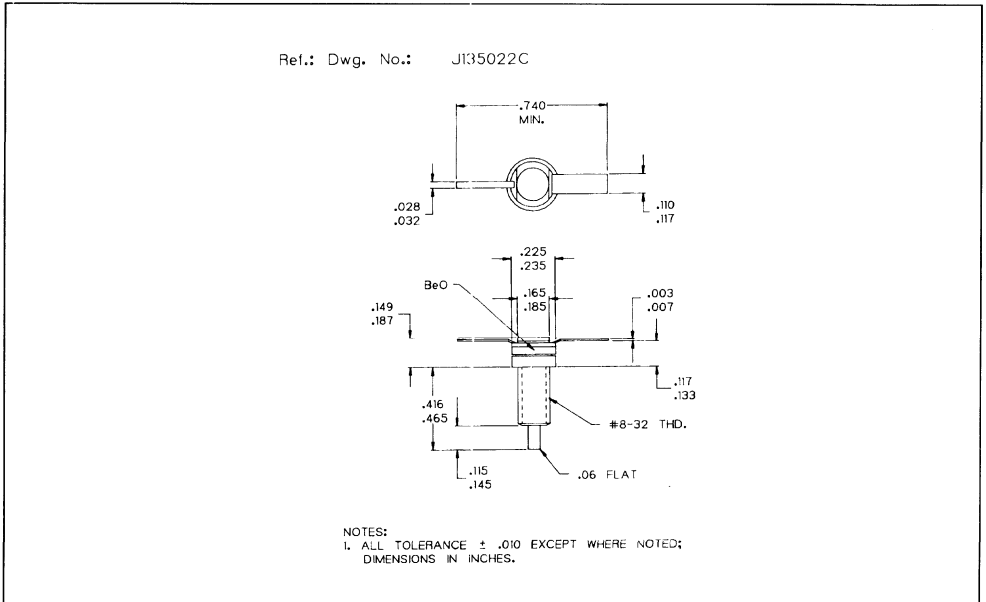
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 35\text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

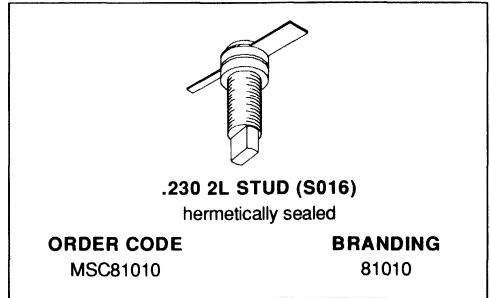


PACKAGE MECHANICAL DATA



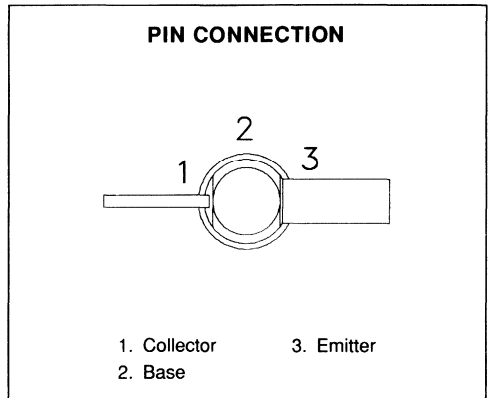
**RF & MICROWAVE TRANSISTORS  
 GENERAL PURPOSE AMPLIFIER APPLICATIONS**

- EMITTER BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 10$  W MIN. WITH 10 dB GAIN @ 1 GHz


**DESCRIPTION**

The MSC81010 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone, emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding infinite load VSWR at any phase angle under rated conditions.

The MSC81010 is designed for Class C amplifier applications in the 0.4 - 1.2 GHz frequency range.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	29	W
$I_C$	Device Current*	1.0	A
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	6.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

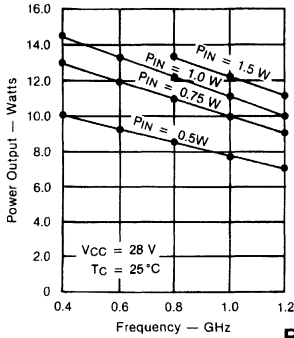
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 10mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	2.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	15	—	120	—

**DYNAMIC**

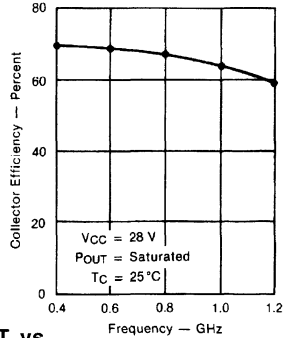
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.0 GHz$	$P_{IN} = 1.0 W$	$V_{CC} = 28 V$	10	11	—	W
$\eta_c$	$f = 1.0 GHz$	$P_{IN} = 1.0 W$	$V_{CC} = 28 V$	60	64	—	%
$G_P$	$f = 1.0 GHz$	$P_{IN} = 1.0 W$	$V_{CC} = 28 V$	10	10.4	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	—	10	pF

**TYPICAL PERFORMANCE**

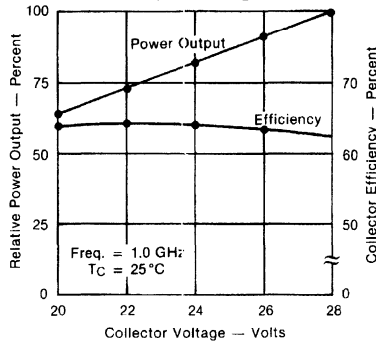
**POWER OUTPUT vs FREQUENCY**



**FREQUENCY vs COLLECTOR EFFICIENCY**

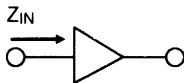


**RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE**

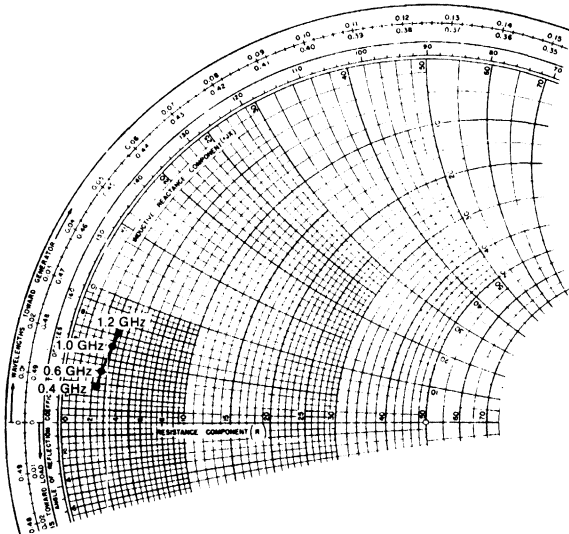


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

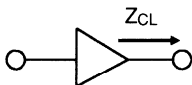


$P_{IN} = 1.0\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms

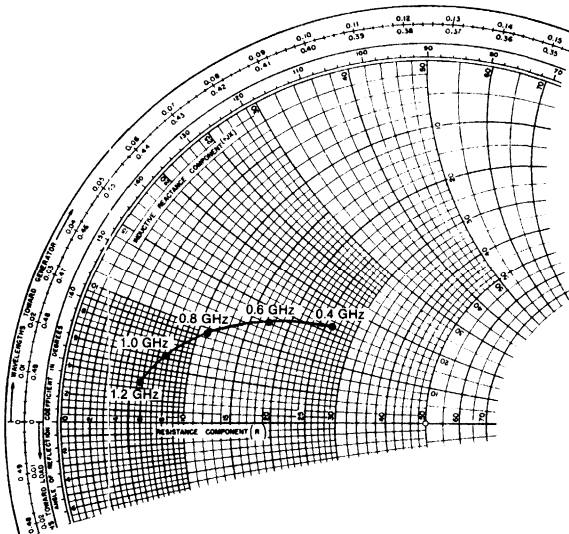


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
0.4 GHz	$2.3 + j 2.7$	$26.0 + j 16.0$
0.6 GHz	$2.5 + j 4.0$	$17.2 + j 13.0$
0.8 GHz	$2.8 + j 5.0$	$11.0 + j 9.5$
1.0 GHz	$3.0 + j 6.0$	$7.7 + j 6.3$
1.2 GHz	$3.3 + j 7.2$	$5.8 + j 3.5$

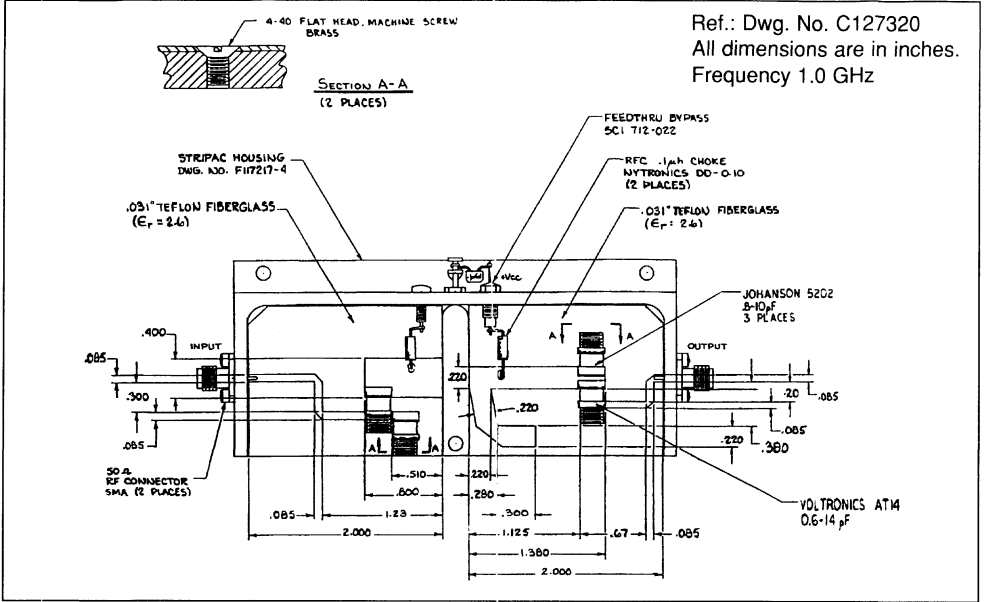
TYPICAL COLLECTOR LOAD IMPEDANCE



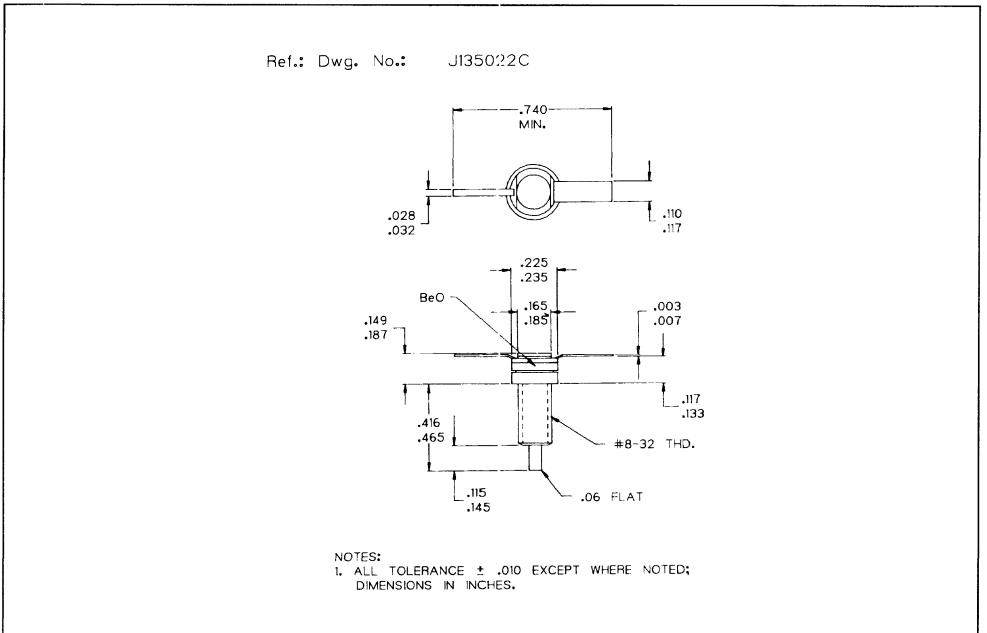
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

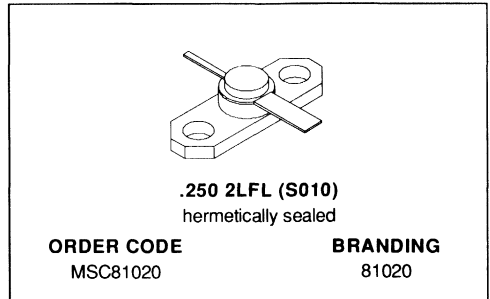


PACKAGE MECHANICAL DATA



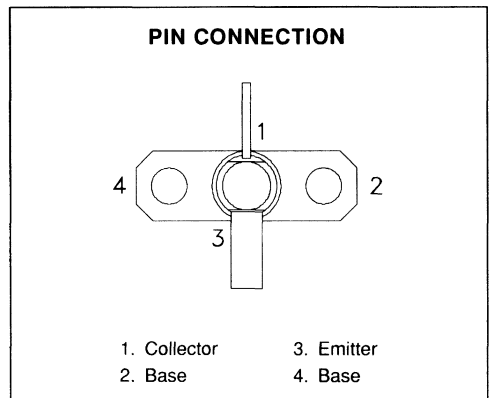
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- EMITTER BALLASTED
- REFRACTORY/GOLD METALLIZATION
- LOW THERMAL RESISTANCE
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 20$  W MIN. WITH 10 dB GAIN @ 1 GHz



### DESCRIPTION

The MSC81020 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone emitter ballasted geometry with a refractory/gold metallization system. This device is designed for Class C amplifier applications in the 0.4 - 1.2 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	35	W
$I_C$	Device Current*	1.50	A
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	5.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

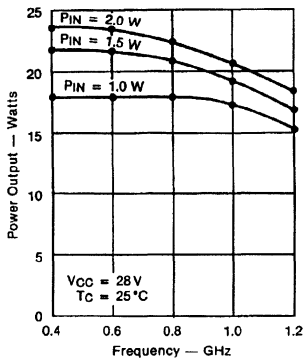
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 15mA	R <sub>BE</sub> = 10Ω	45	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	5.0	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1000mA	15	—	120	—

DYNAMIC

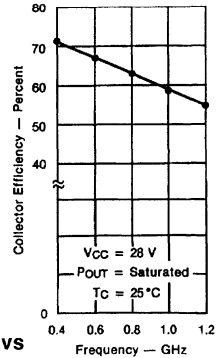
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1.0 GHz	P <sub>IN</sub> = 2.0 W	V <sub>CC</sub> = 28 V	20	21	—	W
η <sub>C</sub>	f = 1.0 GHz	P <sub>IN</sub> = 2.0 W	V <sub>CC</sub> = 28 V	55	58	—	%
G <sub>P</sub>	f = 1.0 GHz	P <sub>IN</sub> = 2.0 W	V <sub>CC</sub> = 28 V	10	10.2	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	19	pF

TYPICAL PERFORMANCE

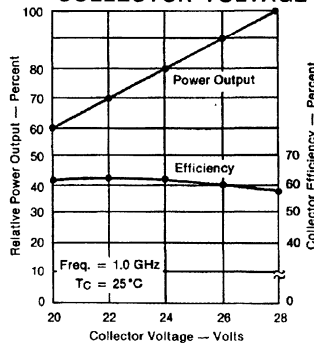
POWER OUTPUT vs FREQUENCY



COLLECTOR EFFICIENCY vs FREQUENCY



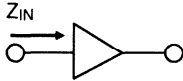
RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE



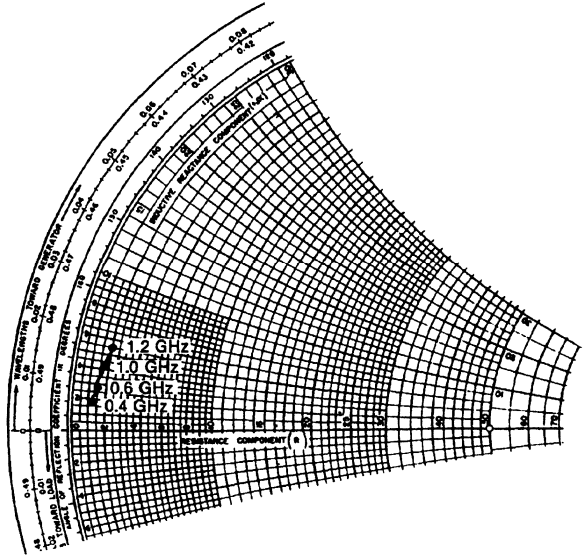


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

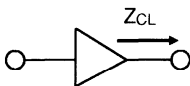


$P_{IN} = 3.0\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms

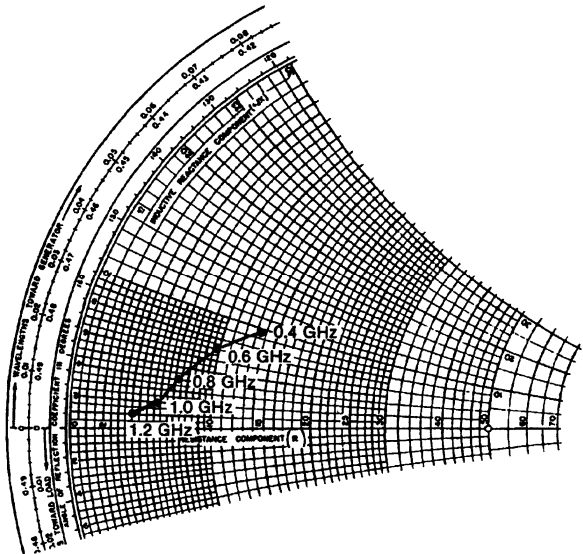


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
0.4 GHz	$1.3 + j 1.7$	$13.3 + j 9.8$
0.6 GHz	$1.5 + j 2.8$	$9.7 + j 7.0$
0.8 GHz	$1.6 + j 3.4$	$7.2 + j 4.0$
1.0 GHz	$1.8 + j 4.2$	$5.8 + j 2.0$
1.2 GHz	$2.0 + j 5.5$	$4.0 + j 1.0$

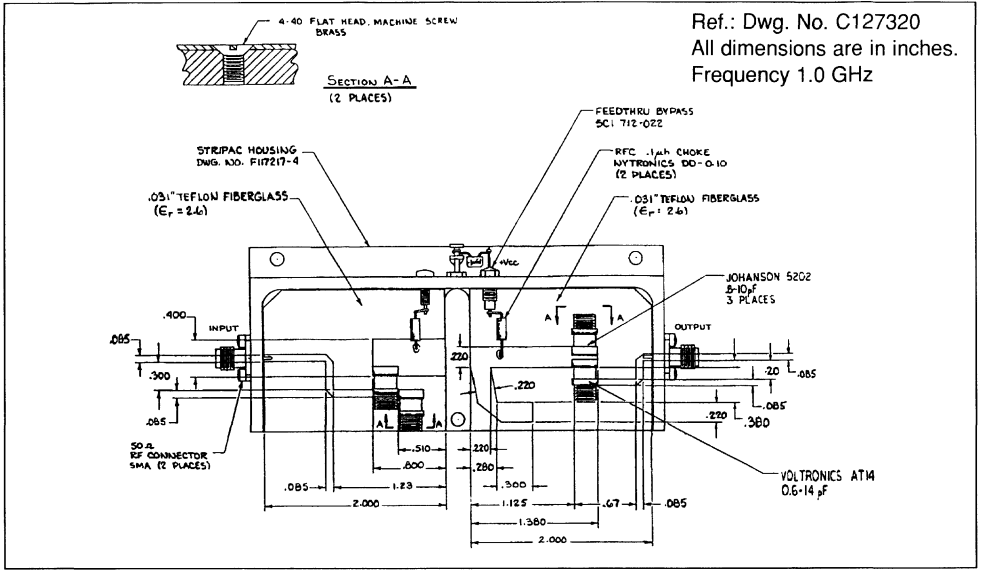
TYPICAL COLLECTOR LOAD IMPEDANCE



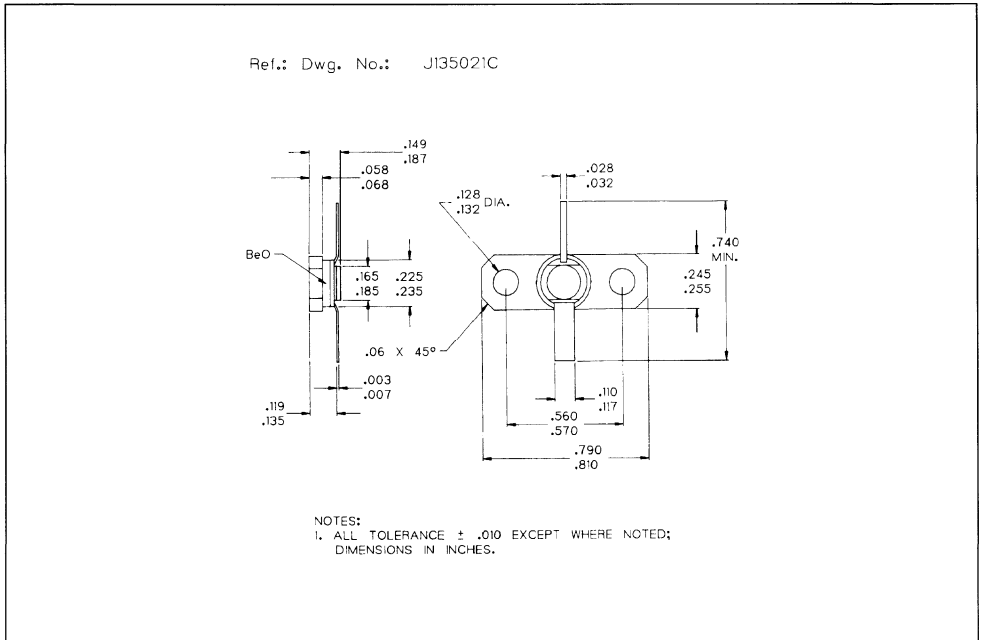
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

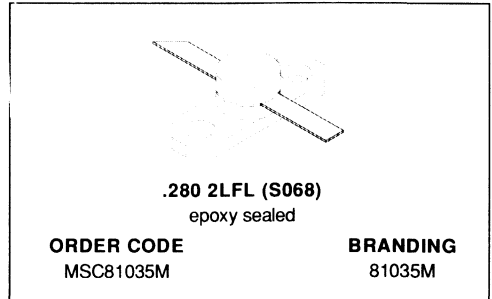


PACKAGE MECHANICAL DATA



## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- ∞:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 35 W MIN. WITH 10.7 dB GAIN

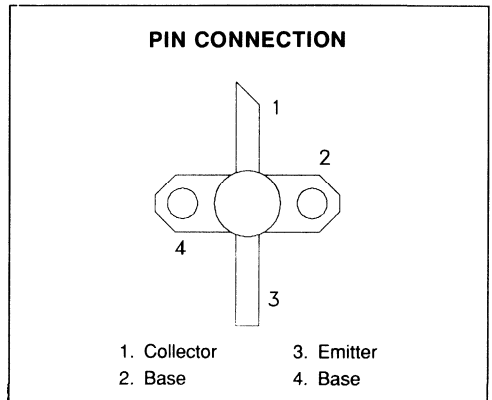


### DESCRIPTION

The MSC81035M is a medium power Class C transistor designed specifically for pulsed L-Band avionics applications. This device is a direct replacement for the MSC1035M. MSC81035M offers improved saturated output power and collector efficiency based on the test circuit described herein.

Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81035M is housed in the IMPAC™ package with internal input matching.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	150	W
I <sub>C</sub>	Device Current*	3.0	A
V <sub>CC</sub>	Collector-Supply Voltage*	55	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	1.0	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

Note: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 10mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 50V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	15	—	120	—

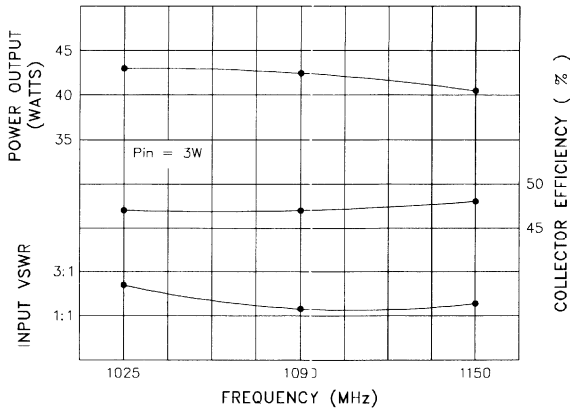
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 3.0W$	$V_{CC} = 50V$	35	40	—	W
$\eta_C$	$f = 1025 - 1150MHz$	$P_{IN} = 3.0W$	$V_{CC} = 50V$	43	48	—	%
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 3.0W$	$V_{CC} = 50V$	10.7	11.2	—	dB

Note: Pulse Width = 10 $\mu$ Sec  
 Duty Cycle = 1%

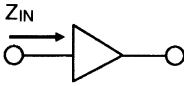
**TYPICAL PERFORMANCE**

**TYPICAL BROADBAND POWER AMPLIFIER**

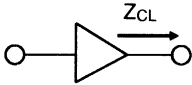


IMPEDANCE DATA

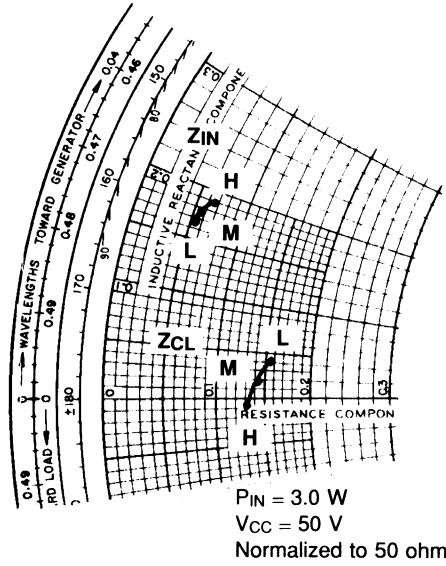
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

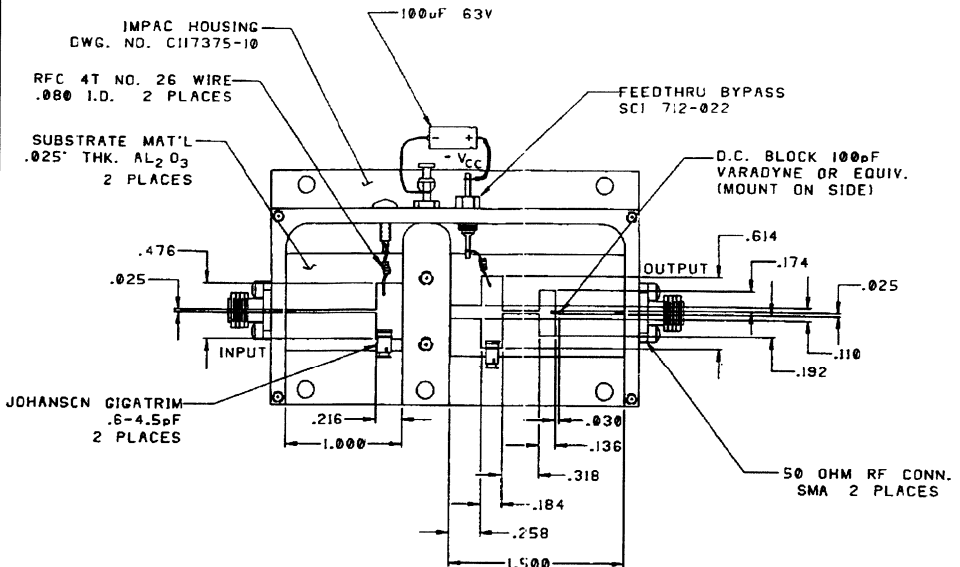


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1025 MHz	2.6 + j 8.3	7.7 + j 2.0
M = 1090 MHz	2.8 + j 8.7	7.1 + j 1.0
H = 1150 MHz	3.2 + j 4.4	6.5 - j 0.5



TEST CIRCUIT

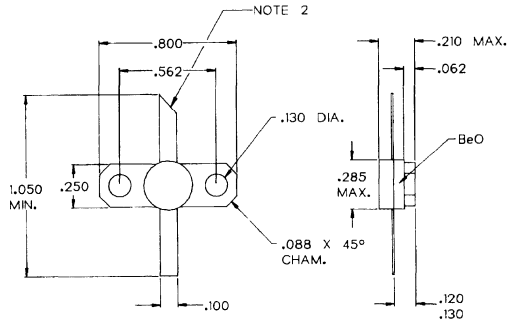
Ref.: Dwg. No. 101 002888



All dimensions are in inches.

PACKAGE MECHANICAL DATA

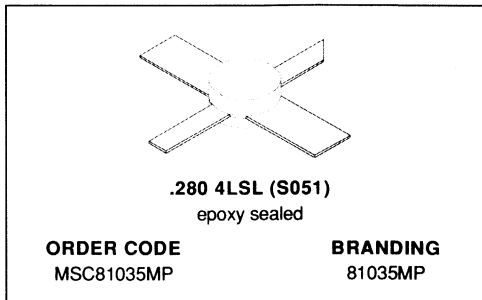
Ref.: Dwg. No.: J135039B



- NOTES:  
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.  
2. COLLECTOR LEAD SLANT CUT.

## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- $\infty$ :1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 35$  W MIN. WITH 10.7 dB GAIN

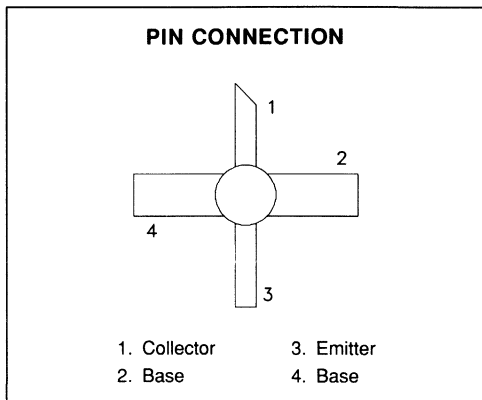


### DESCRIPTION

The MSC81035MP is a medium power Class C transistor designed specifically for pulsed L-Band avionics applications. This device is a direct replacement for the MSC1035MP. MSC81035MP offers improved saturated output power and collector efficiency based on the test circuit described herein.

Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81035MP is housed in the IMPAC™ package with internal input matching.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}C$ )	150	W
$I_C$	Device Current*	3.0	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	1.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

Note: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 10mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 50V$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	15	—	120	—

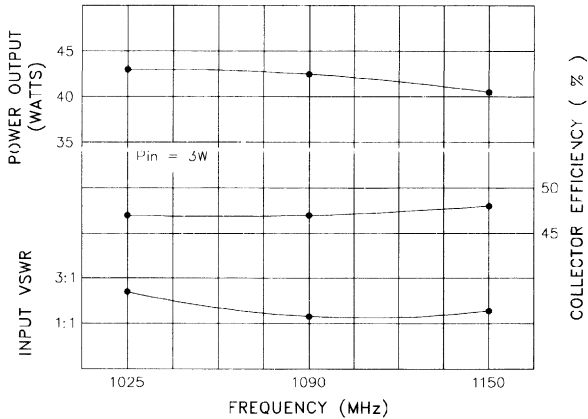
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150 MHz$	$P_{IN} = 3.0W$	$V_{CC} = 50V$	35	40	—	W
$\eta_C$	$f = 1025 - 1150 MHz$	$P_{IN} = 3.0W$	$V_{CC} = 50V$	10.7	11.2	—	%
$G_P$	$f = 1025 - 1150 MHz$	$P_{IN} = 3.0W$	$V_{CC} = 50V$	43	48	—	dB

Note: Pulse Width = 10 $\mu$ Sec  
 Duty Cycle = 1%

**TYPICAL PERFORMANCE**

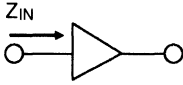
**TYPICAL BROADBAND POWER AMPLIFIER**



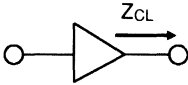


IMPEDANCE DATA

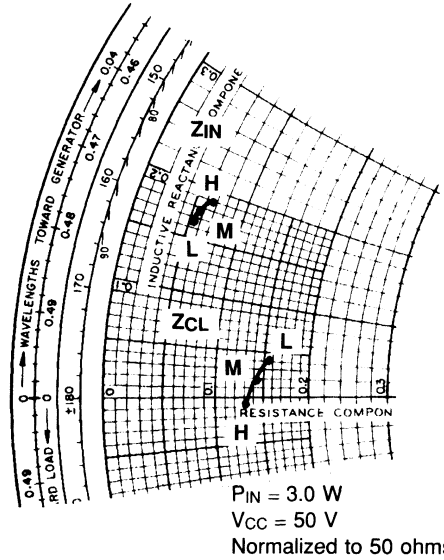
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

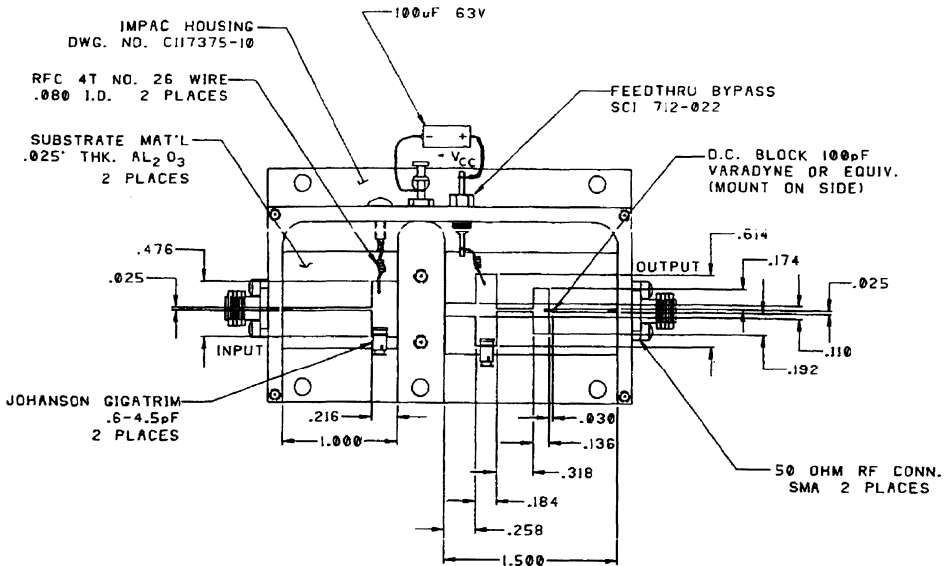


FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 1025 MHz	2.6 + j 8.3	7.7 + j 2.0
M = 1090 MHz	2.8 + j 8.7	7.1 + j 1.0
H = 1150 MHz	3.2 + j 4.4	6.5 - j 0.5



TEST CIRCUIT

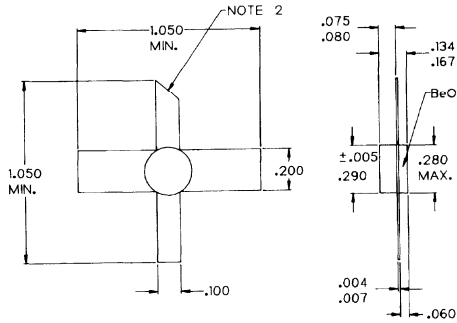
Ref.: Dwg. No. 101 002888



All dimensions are in inches.

PACKAGE MECHANICAL DATA

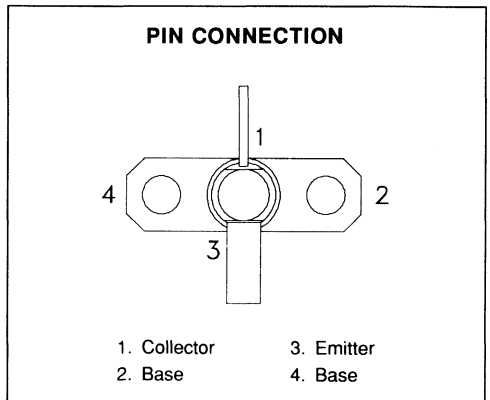
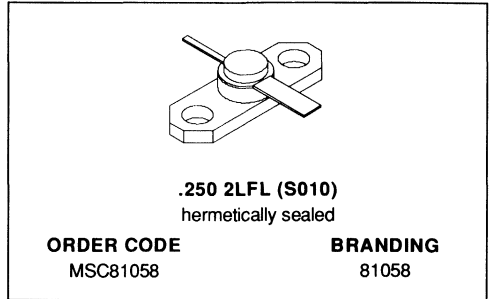
Ref.: Dwg. No.: J135032E



- NOTES:  
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.  
2. COLLECTOR LEAD SLANT CUT.

## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- EMITTER BALLASTED
- REFRACTORY/GOLD METALLIZATION
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 10$  W MIN. WITH 10 dB GAIN @ 1 GHz



### DESCRIPTION

The MSC81058 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone, emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding infinite load VSWR at any phase angle under rated conditions.

The MSC81058 is designed for Class C amplifier applications in the 0.4 - 1.2 GHz frequency range.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation*	29	W
I <sub>C</sub>	Device Current*	1.0	A
V <sub>CC</sub>	Collector-Supply Voltage*	35	V
T <sub>J</sub>	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	6.0	°C/W
----------------------	-----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

STATIC

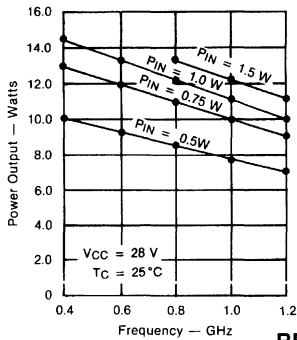
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 10mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	2.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	15	—	120	—

DYNAMIC

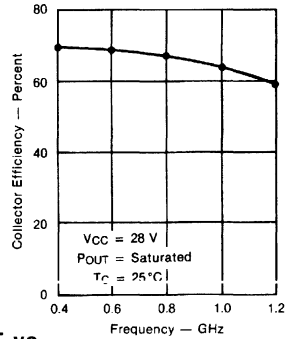
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.0 GHz$	$P_{IN} = 1.0 W$	$V_{CC} = 28 V$	10	11	—	W
$\eta_c$	$f = 1.0 GHz$	$P_{IN} = 1.0 W$	$V_{CC} = 28 V$	60	64	—	%
$G_P$	$f = 1.0 GHz$	$P_{IN} = 1.0 W$	$V_{CC} = 28 V$	10	10.4	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	—	10	pF

TYPICAL PERFORMANCE

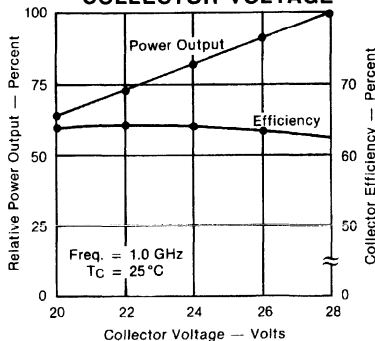
POWER OUTPUT vs FREQUENCY



FREQUENCY vs COLLECTOR EFFICIENCY

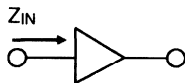


RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE

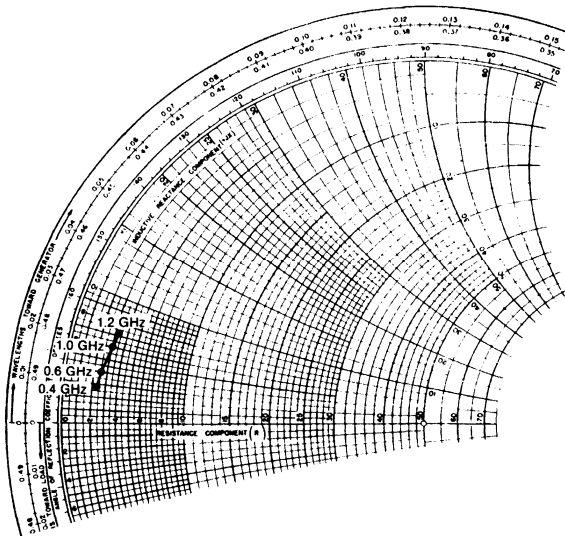


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

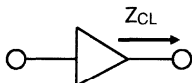


$P_{IN} = 1.0\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms

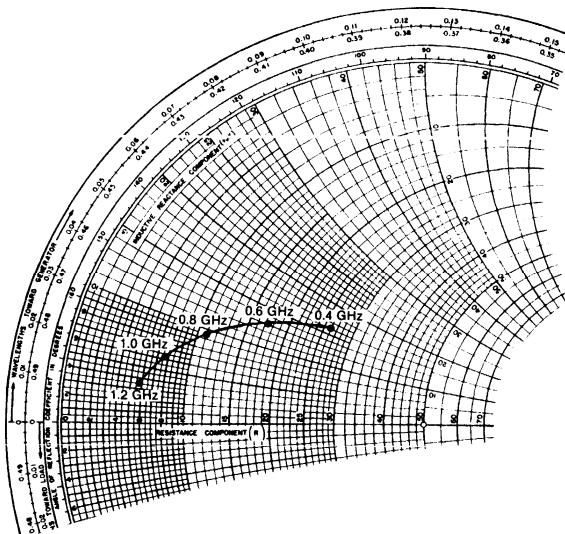


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
0.4 GHz	$2.3 + j 2.7$	$26.0 + j 16.0$
0.6 GHz	$2.5 + j 4.0$	$17.2 + j 13.0$
0.8 GHz	$2.8 + j 5.0$	$11.0 + j 9.5$
1.0 GHz	$3.0 + j 6.0$	$7.7 + j 6.3$
1.2 GHz	$3.3 + j 7.2$	$5.8 + j 3.5$

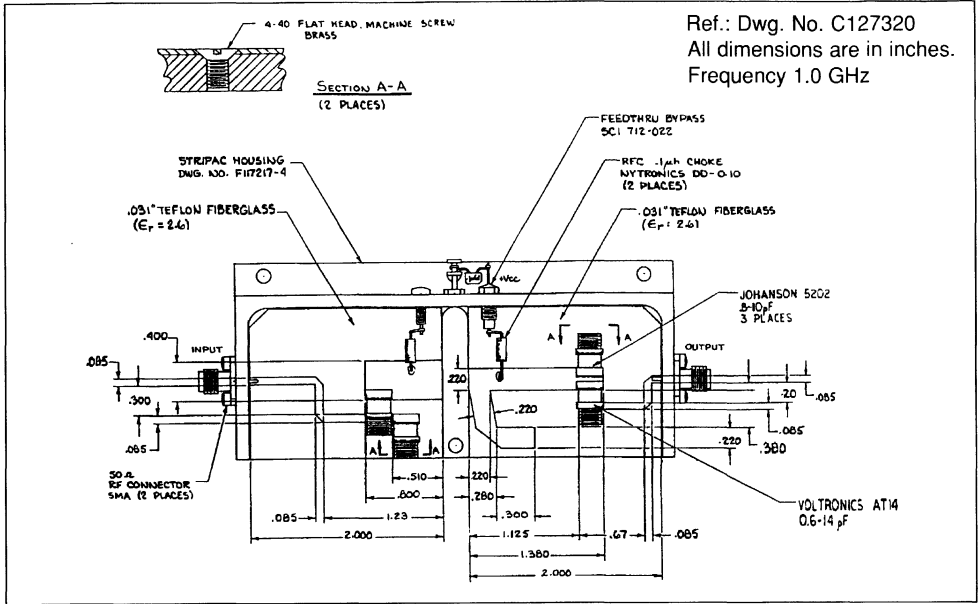
TYPICAL COLLECTOR LOAD IMPEDANCE



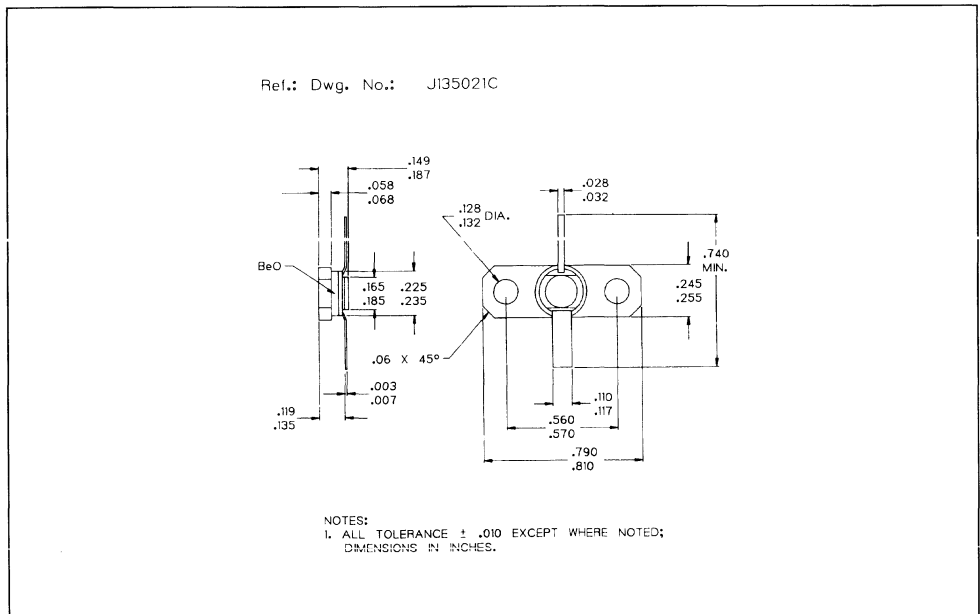
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

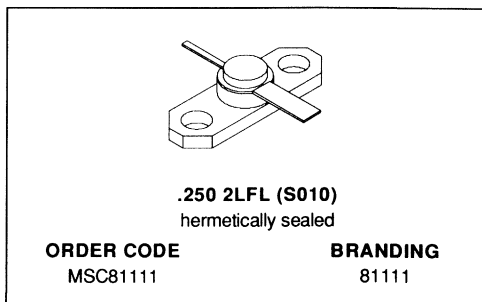


PACKAGE MECHANICAL DATA



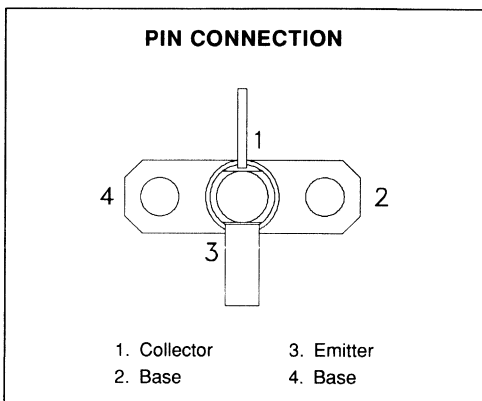
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- EMITTER BALLASTED
- REFRACTORY/GOLD METALLIZATION
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 5.0$  W MIN. WITH 10 dB GAIN @ 1 GHz



### DESCRIPTION

The MSC81111 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC81111 is designed for Class C amplifier applications in the 0.4 - 1.2 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	18.75	W
$I_C$	Device Current*	600	mA
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	8.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

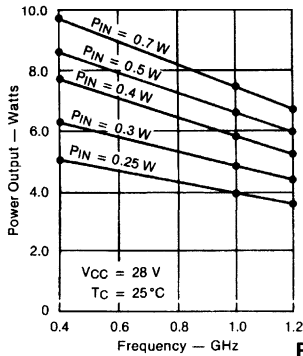
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 1mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 5mA	R <sub>BE</sub> = 10Ω	45	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	1.0	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 200mA	15	—	120	—

DYNAMIC

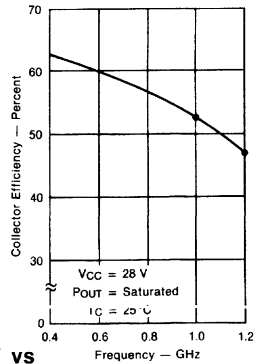
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1.0 GHz	P <sub>IN</sub> = 0.5 W	V <sub>CC</sub> = 28 V	5.0	6.6	—	W
η <sub>C</sub>	f = 1.0 GHz	P <sub>IN</sub> = 0.5 W	V <sub>CC</sub> = 28 V	50	52	—	%
G <sub>P</sub>	f = 1.0 GHz	P <sub>IN</sub> = 0.5 W	V <sub>CC</sub> = 28 V	10	11.2	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	6.5	pF

TYPICAL PERFORMANCE

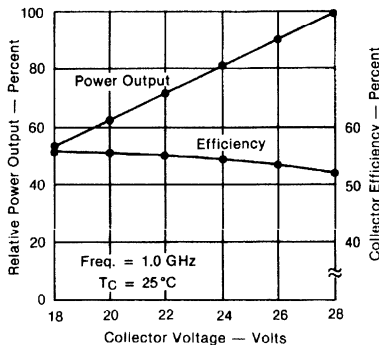
POWER OUTPUT vs FREQUENCY



COLLECTOR EFFICIENCY vs FREQUENCY



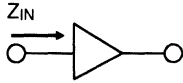
RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE



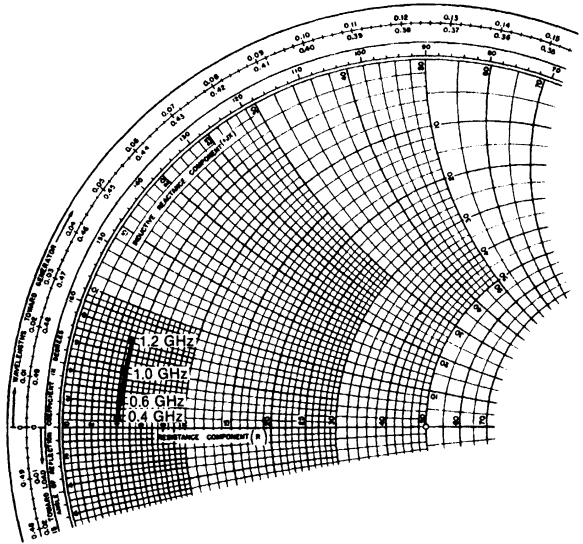


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

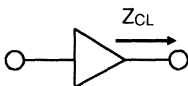


$P_{IN} = 0.5\text{ W}$   
 $V_{CC} = 35\text{ V}$   
 Normalized to 50 ohms

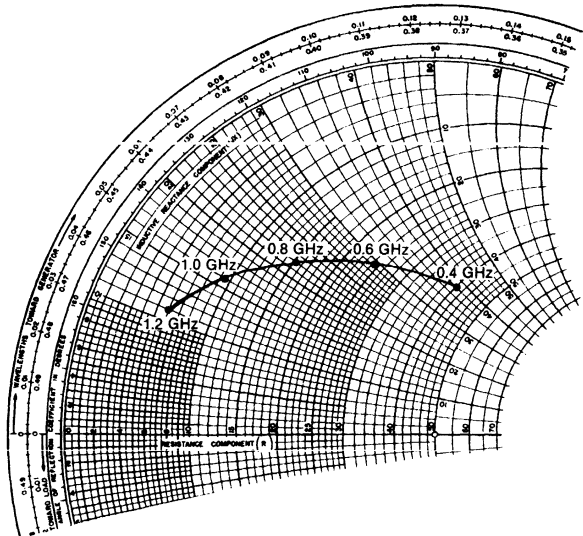


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
0.4 GHz	$4.0 + j\ 0.8$	$40.0 + j\ 38.0$
0.6 GHz	$4.1 + j\ 2.0$	$24.0 + j\ 29.5$
0.8 GHz	$4.2 + j\ 3.2$	$15.0 + j\ 22.0$
1.0 GHz	$4.3 + j\ 4.5$	$9.4 + j\ 16.0$
1.2 GHz	$4.4 + j\ 7.1$	$6.0 + j\ 11.0$

TYPICAL COLLECTOR LOAD IMPEDANCE

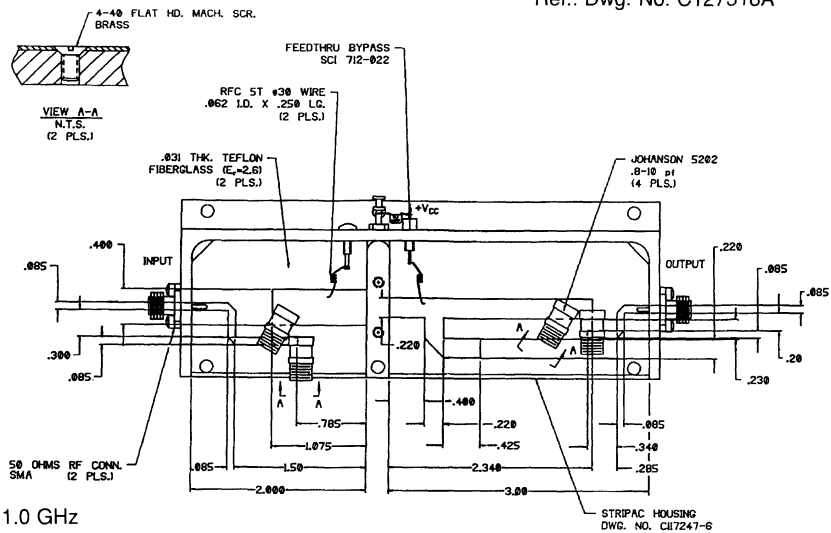


$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 35\text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

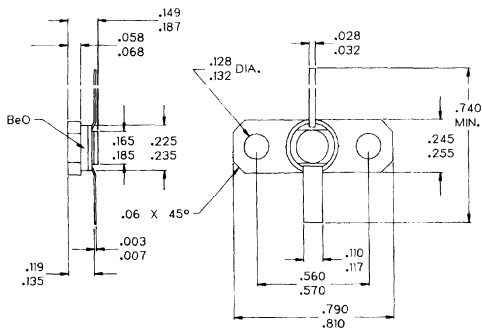
Ref.: Dwg. No. C127318A



Frequency 1.0 GHz  
All dimensions are in inches.

PACKAGE MECHANICAL DATA

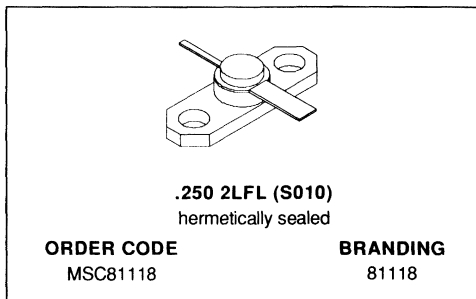
Ref.: Dwg. No.: JI35021C



NOTES:  
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

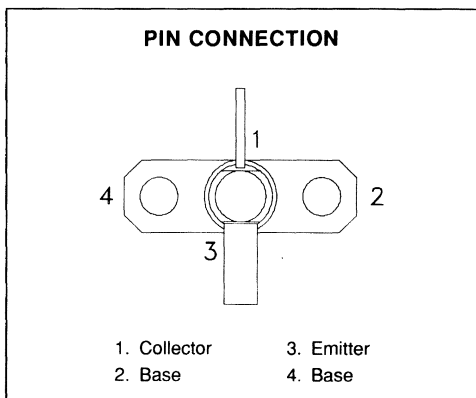
**RF & MICROWAVE TRANSISTORS  
 GENERAL PURPOSE AMPLIFIER APPLICATIONS**

- EMITTER BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC<sup>®</sup> PACKAGE
- $P_{OUT} = 2.0$  W MIN. WITH 10 dB GAIN @ 1.0 GHz


**DESCRIPTION**

The MSC81118 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone, emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions.

The MSC81118 was designed for Class C amplifier applications in the 0.4 - 1.2 GHz frequency range.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 75^{\circ}C$ )	6.25	W
$I_C$	Device Current*	200	mA
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	20	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

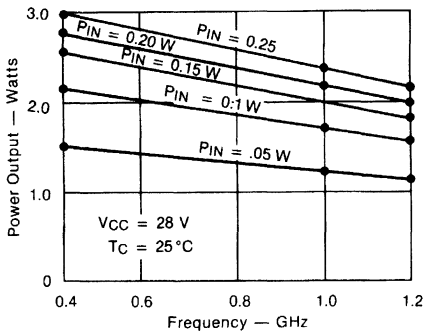
**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

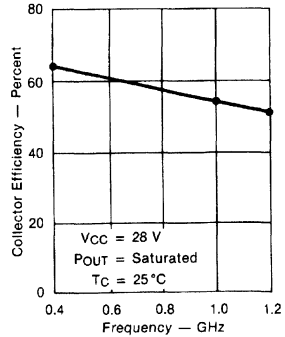
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.0 GHz$	$P_{IN} = 0.2 W$	$V_{CC} = 28 V$	2.0	2.2	—	W
$\eta_C$	$f = 1.0 GHz$	$P_{IN} = 0.2 W$	$V_{CC} = 28 V$	50	55	—	%
$G_P$	$f = 1.0 GHz$	$P_{IN} = 0.2 W$	$V_{CC} = 28 V$	10	10.4	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	—	3.2	pF

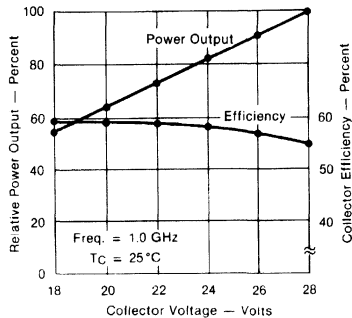
**TYPICAL PERFORMANCE**  
**POWER OUTPUT vs FREQUENCY**



**COLLECTOR EFFICIENCY vs FREQUENCY**

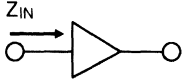


**RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE**

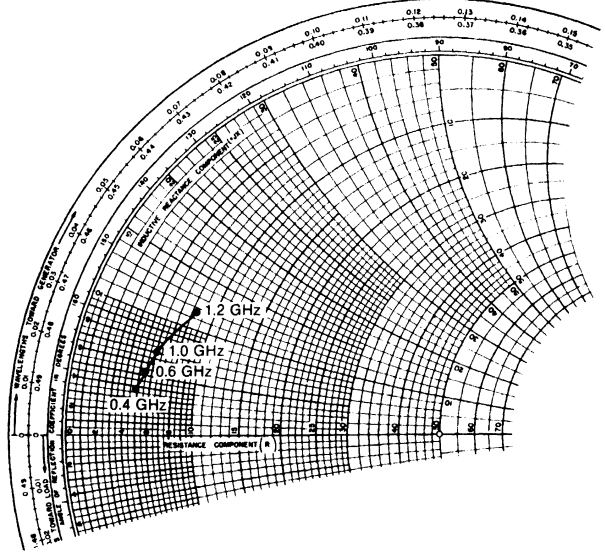


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

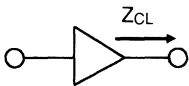


$P_{IN} = 0.2\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms

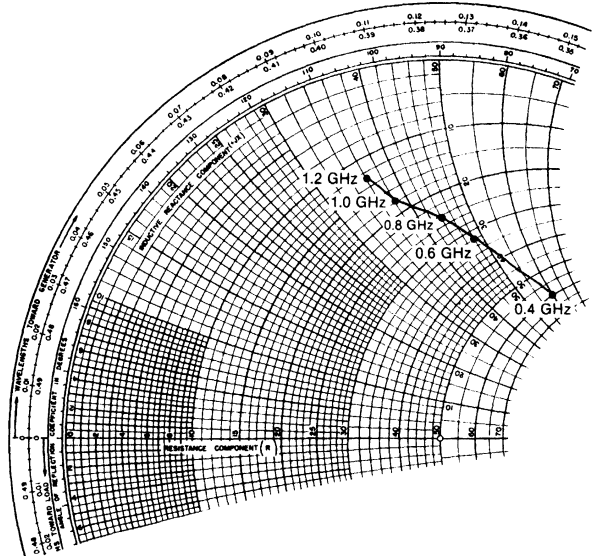


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
0.4 GHz	$4.8 + j 3.7$	$60.0 + j 60.0$
0.6 GHz	$5.4 + j 5.3$	$32.0 + j 48.0$
1.0 GHz	$6.0 + j 7.0$	$18.0 + j 38.0$
1.2 GHz	$8.2 + j 11.6$	$12.8 + j 36.0$

TYPICAL COLLECTOR LOAD IMPEDANCE



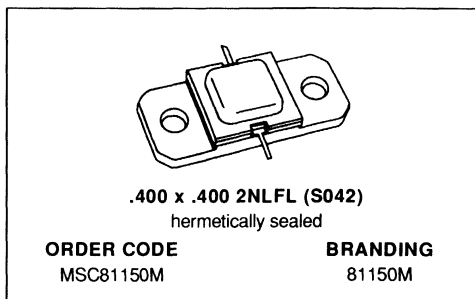
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms





**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

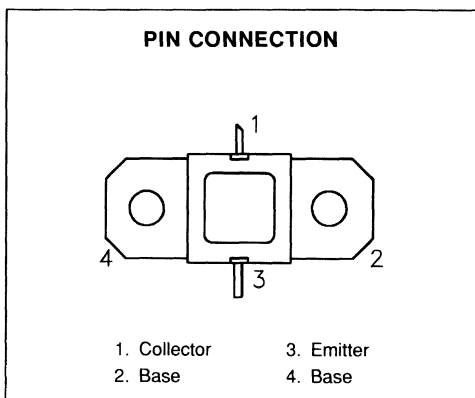
- REFRACTORY/GOLD METALLIZATION
- RUGGIZED VSWR 20:1
- LOW THERMAL RESISTANCE
- INTERNAL INPUT/OUTPUT MATCHING
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 150$  W MIN. WITH 7.8 dB GAIN


**DESCRIPTION**

The MSC81150M device is a high power pulsed transistor specifically designed for DME/TACAN avionics applications.

This device is capable of withstanding a minimum 20:1 load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi-automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81150M is housed in the unique AMPAC™ package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	400	W
$I_C$	Device Current*	11	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.3	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

# MSC81150M

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 15mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	12.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	120	—

### DYNAMIC

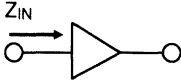
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150$ MHz	$P_{IN} = 25$ W	$V_{CC} = 50$ V	150	170	—	W
$\eta_C$	$f = 1025 - 1150$ MHz	$P_{IN} = 25$ W	$V_{CC} = 50$ V	40	42	—	%
$G_P$	$f = 1025 - 1150$ MHz	$P_{IN} = 25$ W	$V_{CC} = 50$ V	7.8	8.3	—	dB

Note: Pulse Width = 10 $\mu$ Sec  
Duty Cycle = 1%

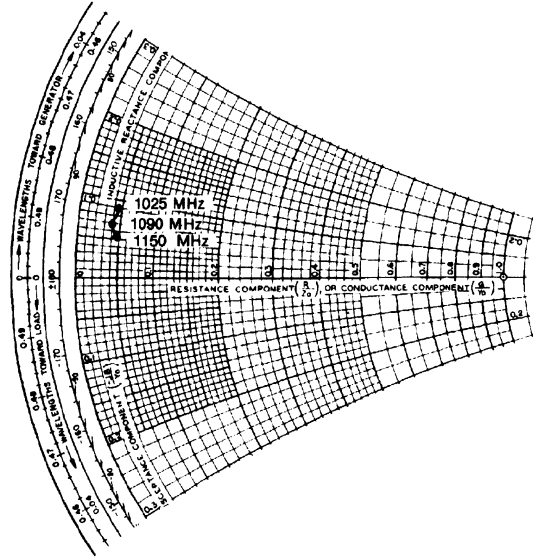


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

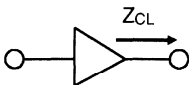


$P_{IN} = 25$  W Peak  
 $V_{CC} = 50$  V  
 Normalized to 50 ohms

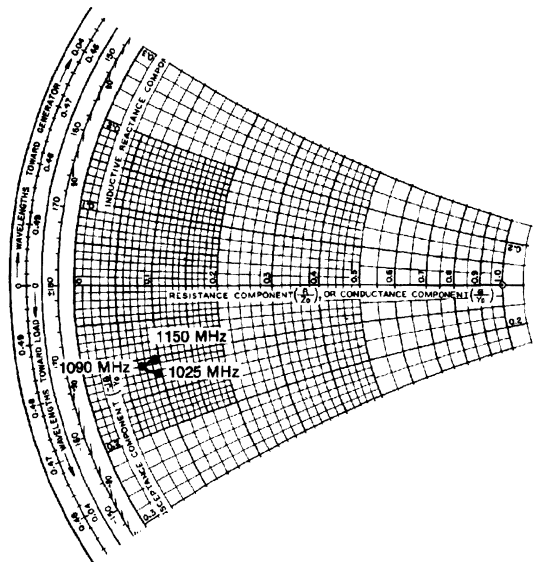


FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
L = 1025 MHz	$2.2 + j 5.0$	$4.7 - j 6.2$
M = 1090 MHz	$2.0 + j 3.5$	$3.6 - j 5.5$
H = 1150 MHz	$2.3 + j 2.7$	$4.8 - j 5.2$

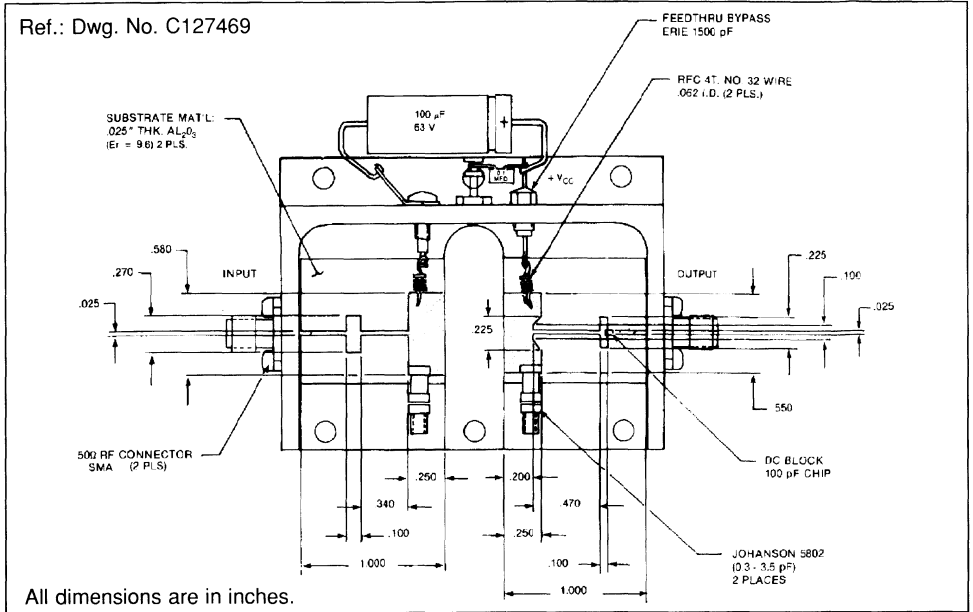
TYPICAL COLLECTOR LOAD IMPEDANCE



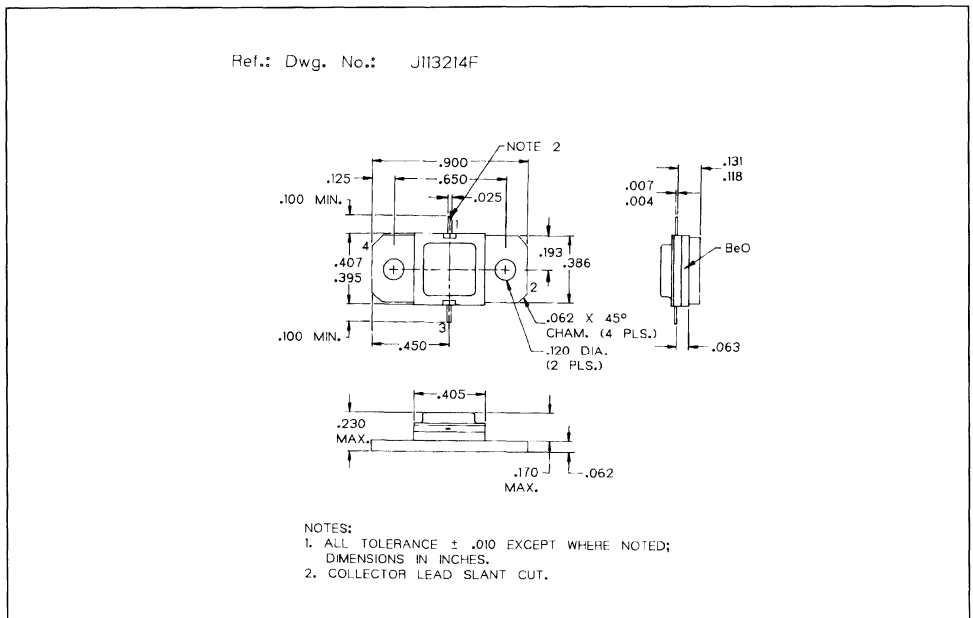
$P_{OUT} =$  Saturated  
 $V_{CC} = 50$  V  
 Normalized to 50 ohms



TEST CIRCUIT

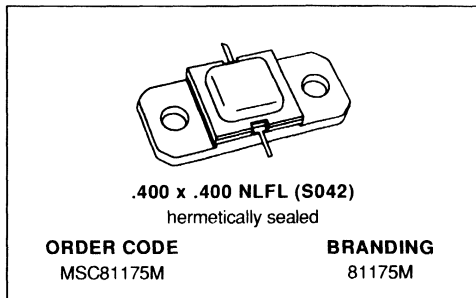


PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

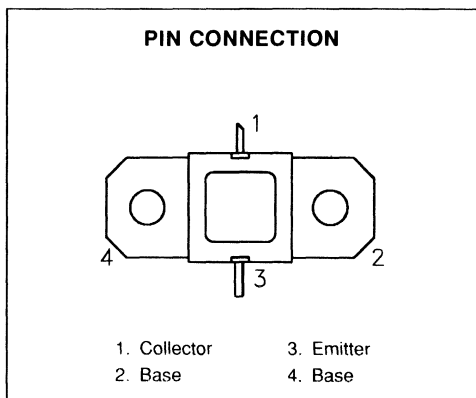
- REFRACTORY/GOLD METALLIZATION
- RUGGEDIZED VSWR 20:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 175 \text{ W MIN. WITH } 7.7 \text{ dB GAIN}$


**DESCRIPTION**

The MSC81175M device is a high power pulsed transistor specifically designed for DME/TACAN avionics applications.

This device is capable of withstanding a minimum 20:1 load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81175M is housed in the unique AMPAC™ package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	400	W
$I_C$	Device Current*	12	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.3	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

**MSC81175M****ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10\text{mA}$	$I_E = 0\text{mA}$	65	—	—	V
$BV_{EBO}$	$I_E = 1\text{mA}$	$I_C = 0\text{mA}$	3.5	—	—	V
$BV_{CER}$	$I_C = 15\text{mA}$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{CE} = 50\text{V}$		—	—	12.5	mA
$h_{FE}$	$V_{CE} = 5\text{V}$	$I_C = 1\text{A}$	15	—	120	—

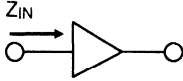
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150\text{ MHz}$	$P_{IN} = 30\text{ W}$	$V_{CC} = 50\text{ V}$	175	190	—	W
$\eta_C$	$f = 1025 - 1150\text{ MHz}$	$P_{IN} = 30\text{ W}$	$V_{CC} = 50\text{ V}$	40	42	—	%
$G_P$	$f = 1025 - 1150\text{ MHz}$	$P_{IN} = 30\text{ W}$	$V_{CC} = 50\text{ V}$	7.7	8.0	—	dB

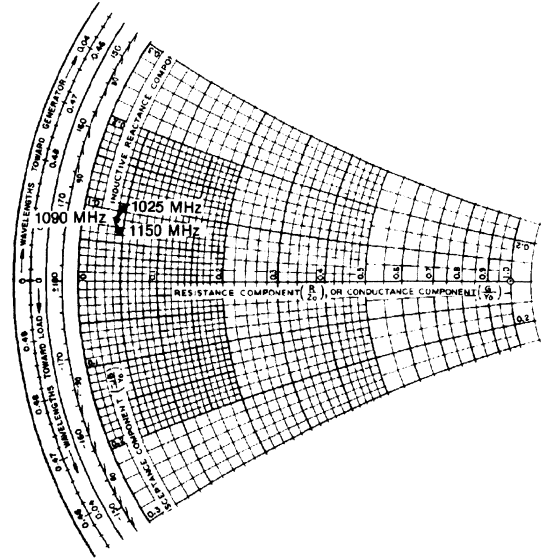
Note: Pulse Width =  $10\mu\text{Sec}$   
 Duty Cycle = 1%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

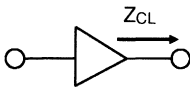


$P_{IN} = 30\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms

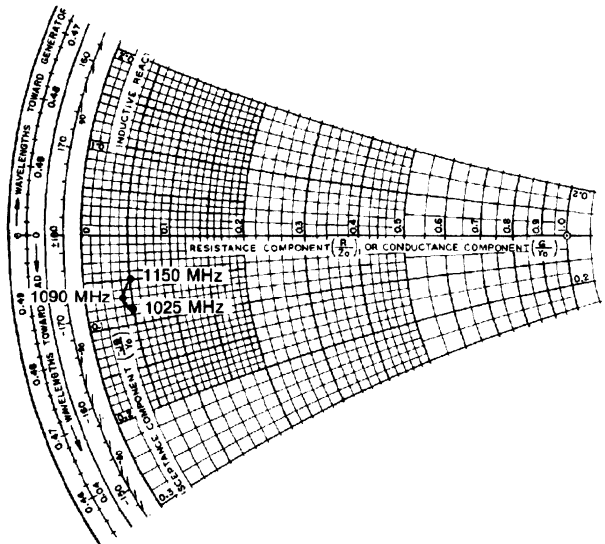


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1025 MHz	$2.3 + j 5.1$	$2.4 - j 4.2$
M = 1090 MHz	$2.0 + j 4.5$	$2.0 - j 3.5$
H = 1150 MHz	$2.2 + j 3.3$	$2.5 - j 2.5$

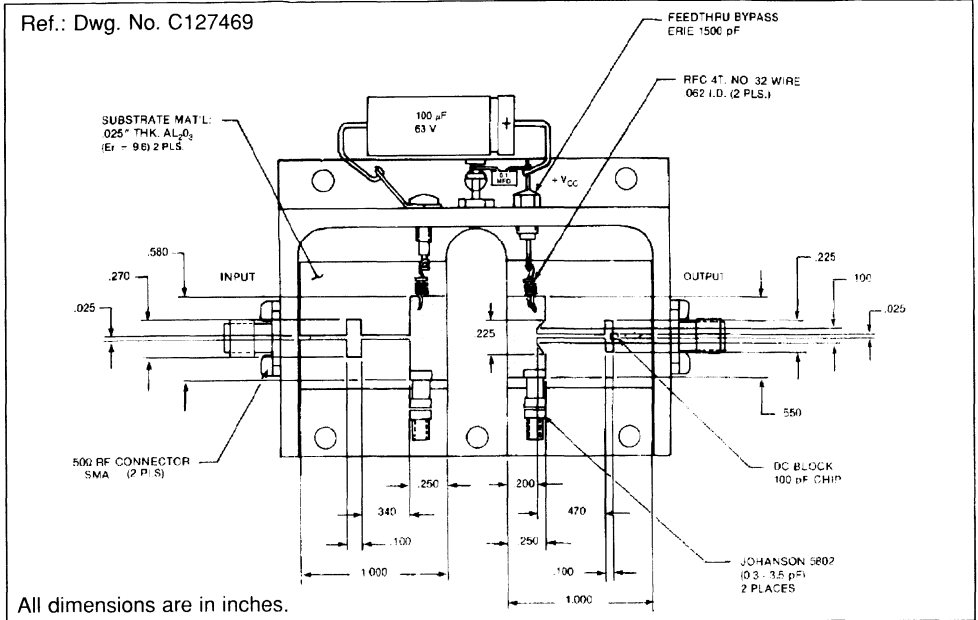
TYPICAL COLLECTOR LOAD IMPEDANCE



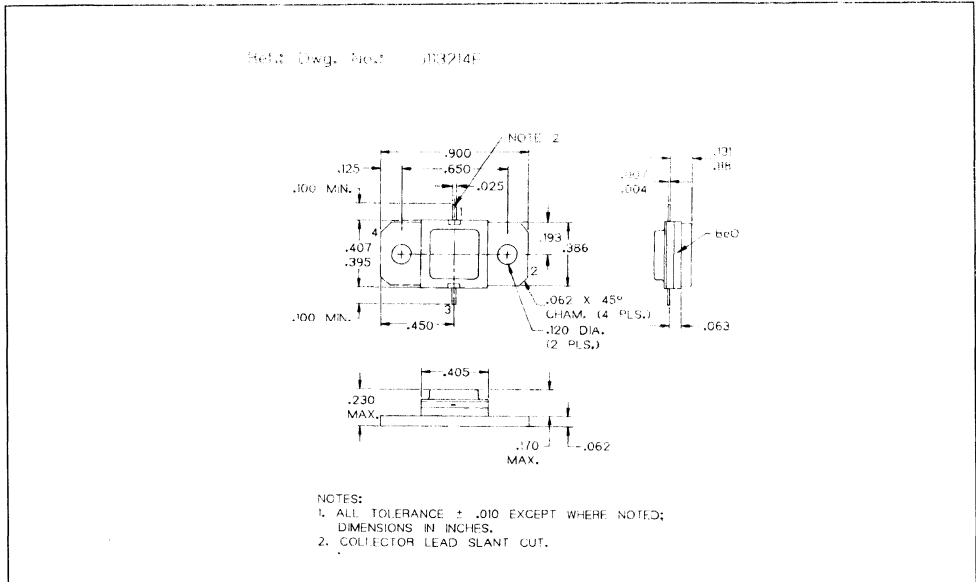
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

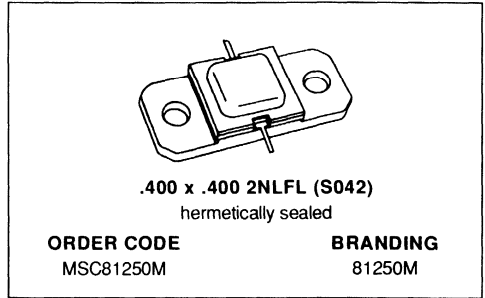


PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

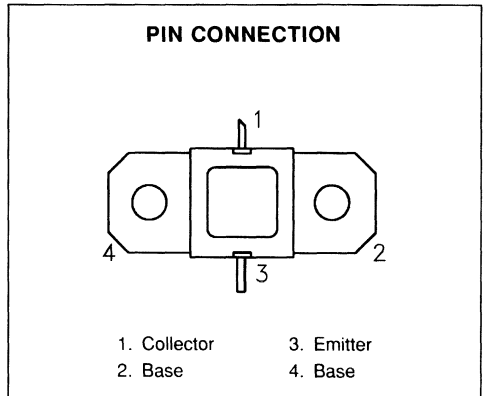
- REFRACTORY/GOLD METALLIZATION
- RUGGEDIZED VSWR 20:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 250$  W MIN. WITH 6.2 dB GAIN


**DESCRIPTION**

The MSC81250M device is a high power pulsed transistor specifically designed for DME/TACAN avionics applications.

This device is capable of withstanding a minimum 20:1 load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81250M is housed in the unique AMPAC™ package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 80^{\circ}C$ )	600	W
$I_C$	Device Current*	17.8	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.20	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

## MSC81250M

### ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

#### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	120	—

#### DYNAMIC

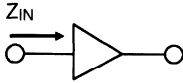
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150$ MHz	$P_{IN} = 60$ W	$V_{CC} = 50$ V	250	270	—	W
$\eta_C$	$f = 1025 - 1150$ MHz	$P_{IN} = 60$ W	$V_{CC} = 50$ V	40	38	—	%
GP	$f = 1025 - 1150$ MHz	$P_{IN} = 60$ W	$V_{CC} = 50$ V	6.2	6.5	—	dB

Note: Pulse Width = 10 $\mu$ Sec  
Duty Cycle = 1%

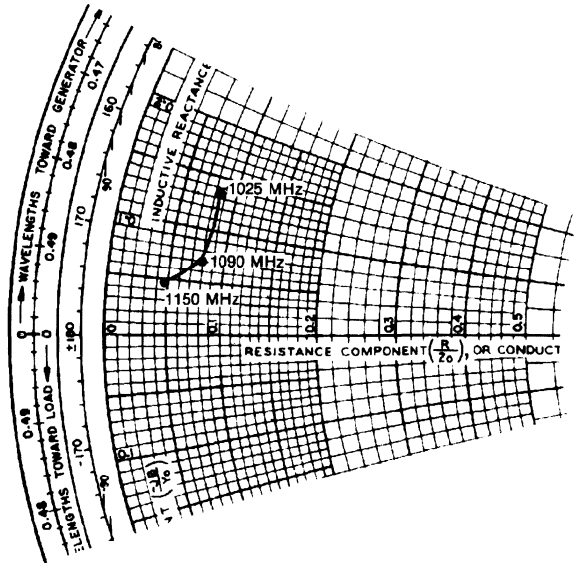


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

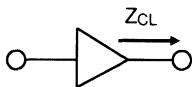


$P_{IN} = 60\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms

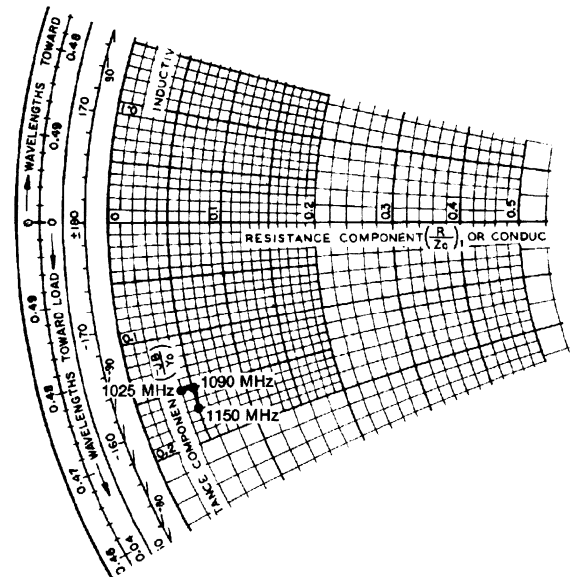


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1025 MHz	$4.2 + j 6.7$	$2.0 - j 7.5$
M = 1090 MHz	$4.0 + j 3.5$	$2.5 - j 7.5$
H = 1150 MHz	$2.3 + j 2.3$	$2.5 - j 8.5$

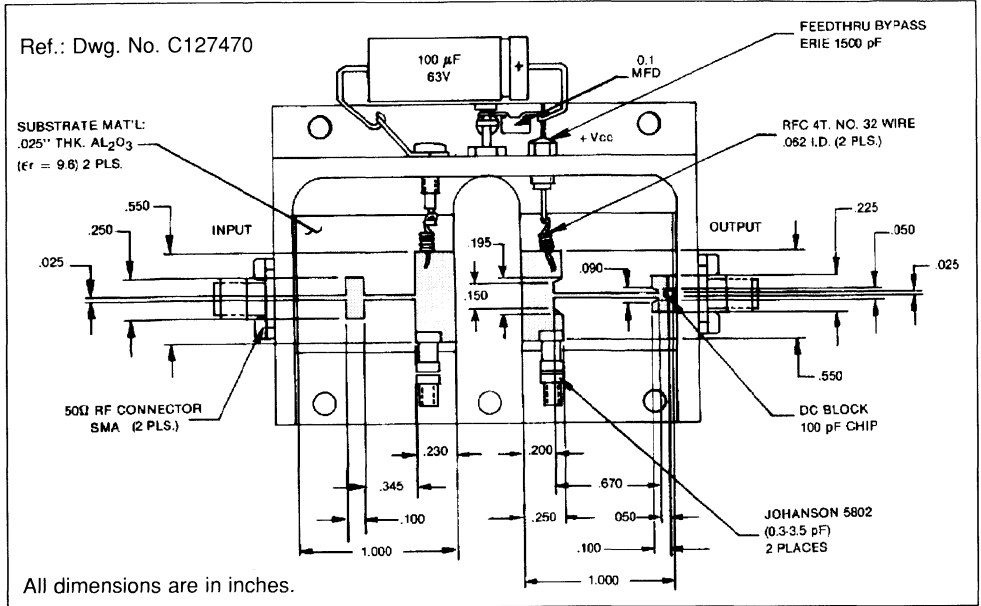
TYPICAL COLLECTOR LOAD IMPEDANCE



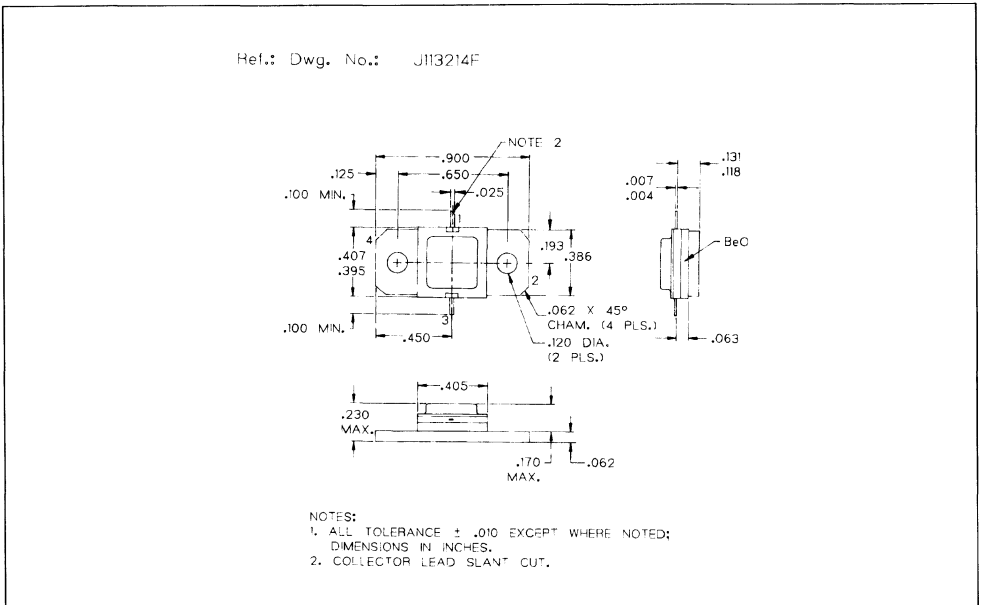
$P_{IN} = 60\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

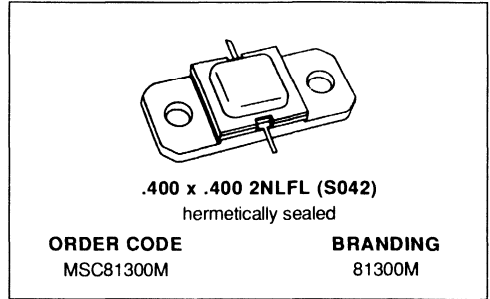


PACKAGE MECHANICAL DATA



## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY\GOLD METALLIZATION
- RUGGEDIZED VSWR 20:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL\CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 300 \text{ W MIN. WITH } 6.3 \text{ dB GAIN}$

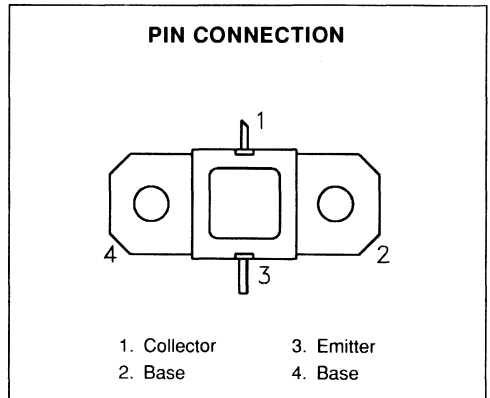


### DESCRIPTION

The MSC81300M device is a high power pulsed transistor specifically designed for IFF avionics applications.

This device is capable of withstanding a minimum 20:1 load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81300M is housed in the unique AMPAC™ package with internal input/output matching structures.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	625	W
$I_c$	Device Current*	18.8	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.20	$^{\circ}\text{C/W}$
---------------	-----------------------------------	------	----------------------

\*Applies only to rated RF amplifier operation

## MSC81300M

### ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

#### STATIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 10\text{mA}$	$I_{\text{E}} = 0\text{mA}$	65	—	—	V	
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V	
$BV_{\text{CER}}$	$I_{\text{C}} = 25\text{mA}$	$R_{\text{BE}} = 10\Omega$	65	—	—	V	
$I_{\text{CES}}$	$V_{\text{CE}} = 50\text{V}$		—	—	25	mA	
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 1\text{A}$	15	—	120	—	

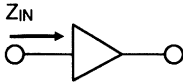
#### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 1090\text{ MHz}$	$P_{\text{IN}} = 70\text{ W}$	$V_{\text{CC}} = 50\text{ V}$	300	330	—	W
$\eta_{\text{C}}$	$f = 1090\text{ MHz}$	$P_{\text{IN}} = 70\text{ W}$	$V_{\text{CC}} = 50\text{ V}$	35	42	—	%
$G_{\text{P}}$	$f = 1090\text{ MHz}$	$P_{\text{IN}} = 70\text{ W}$	$V_{\text{CC}} = 50\text{ V}$	6.3	6.7	—	dB

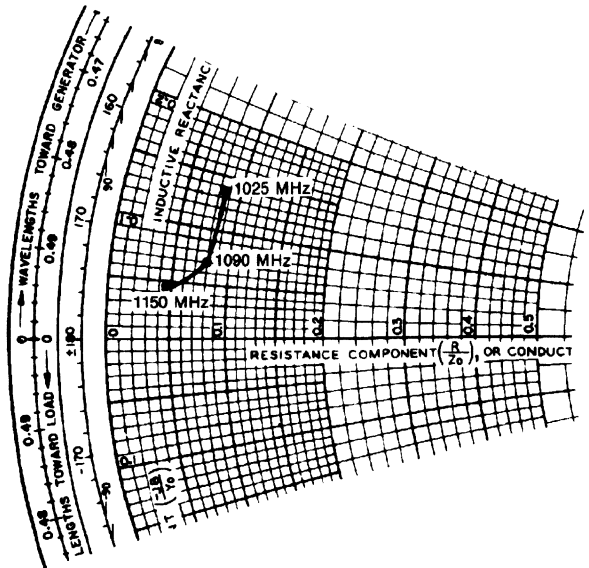
Note: Pulse Width =  $10\mu\text{Sec}$   
Duty Cycle = 1%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

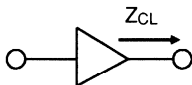


$P_{IN} = 70\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms

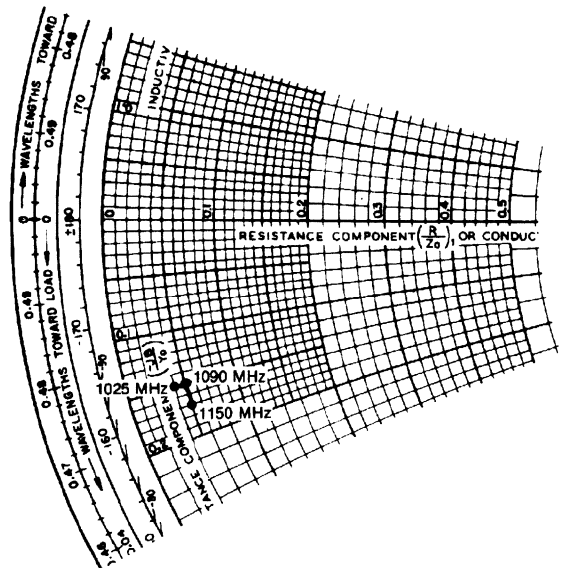


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
1025 MHz	$4.2 + j 6.7$	$2.0 - j 7.5$
1090 MHz	$4.0 + j 3.5$	$2.5 - j 7.5$
1150 MHz	$2.3 + j 2.3$	$2.5 - j 8.5$

TYPICAL COLLECTOR LOAD IMPEDANCE

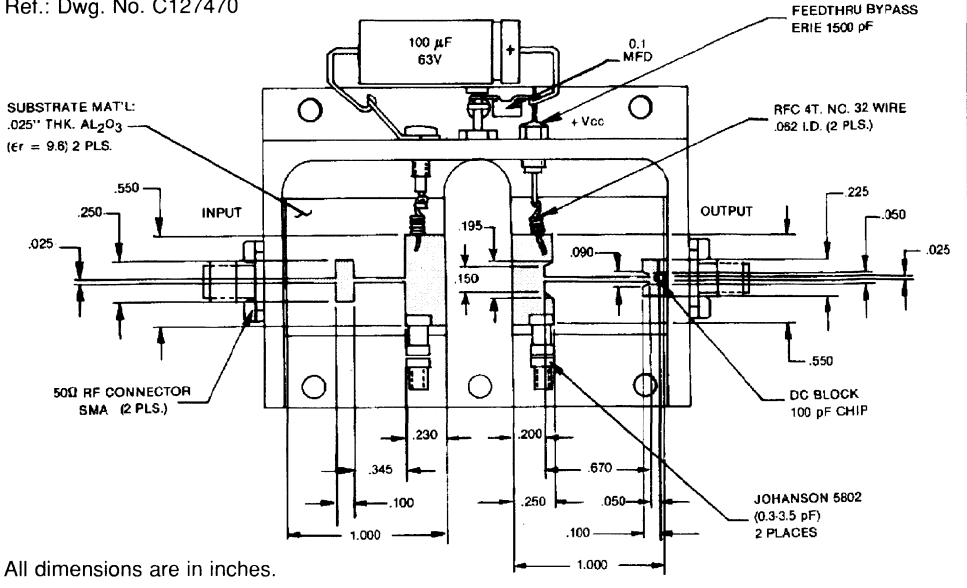


$P_{IN} = 70\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms



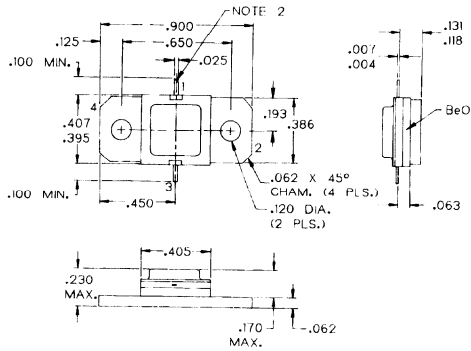
TEST CIRCUIT

Ref.: Dwg. No. C127470



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



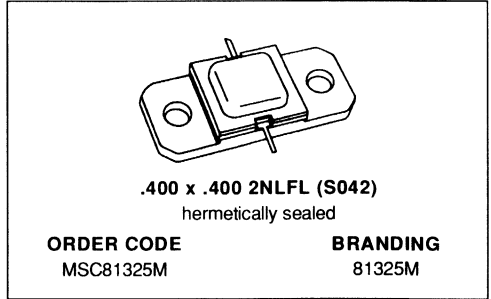
- NOTES:
1. ALL TOLERANCE ± .010 EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
  2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- EMITTER BALLASTED
- RUGGEDIZED VSWR  $\infty:1$
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 325 \text{ W MIN. WITH } 6.7 \text{ dB GAIN}$

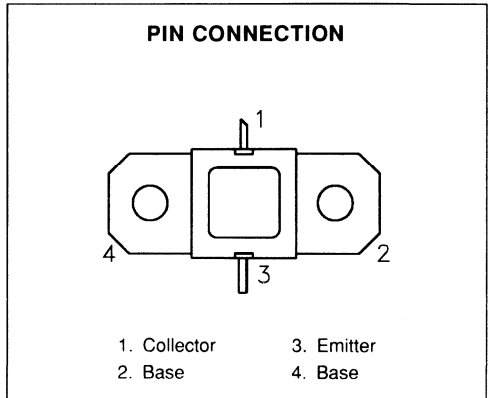


**DESCRIPTION**

The MSC81325M device is a high power pulsed transistor specifically designed for DME/TACAN avionics applications.

This device is capable of withstanding an infinite load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi-automatic bonding techniques ensure high reliability and product consistency.

The MSC81325M is housed in the industry-standard AMPAC™ metal/ceramic hermetic package with internal input/output matching structures.



**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}\text{C}$ )	880	W
$I_C$	Device Current*	24	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.17	$^{\circ}\text{C/W}$
---------------	-----------------------------------	------	----------------------

\*Applies only to rated RF amplifier operation

# MSC81325M

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 10mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 25mA	R <sub>BE</sub> = 10Ω	65	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 50V	—	—	25	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	15	—	120	—

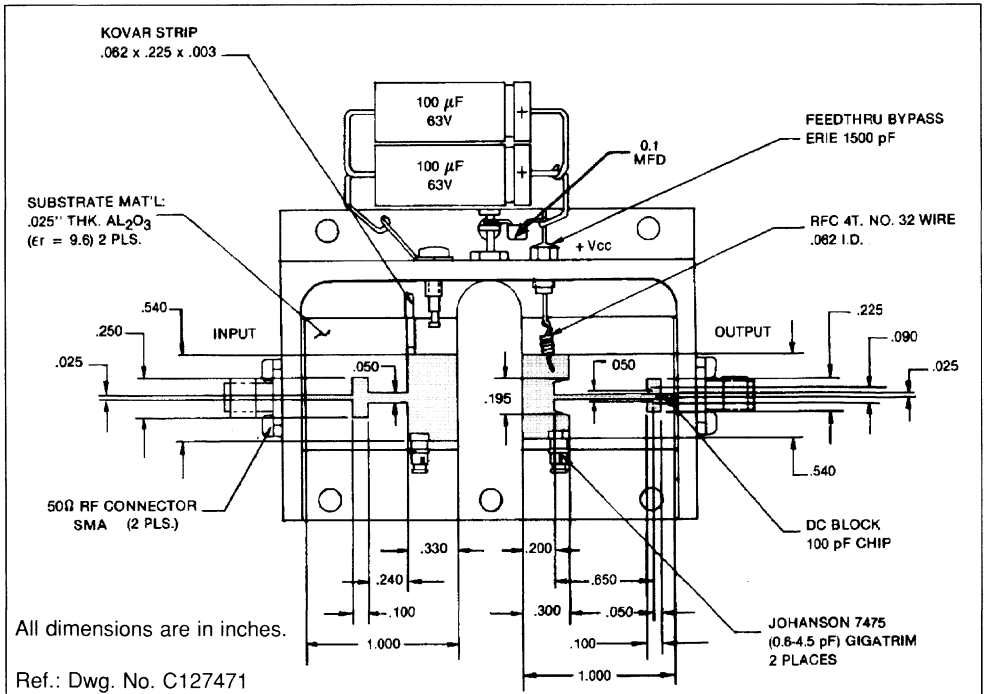
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1025 — 1150 MHz	P <sub>IN</sub> = 70 W	V <sub>CC</sub> = 50 V	325	360	—	W
η <sub>c</sub>	f = 1025 — 1150 MHz	P <sub>IN</sub> = 70 W	V <sub>CC</sub> = 50 V	40	41	—	%
GP	f = 1025 — 1150 MHz	P <sub>IN</sub> = 70 W	V <sub>CC</sub> = 50 V	6.7	7.1	—	dB

Note: Pulse Width = 10μSec

Duty Cycle = 1%

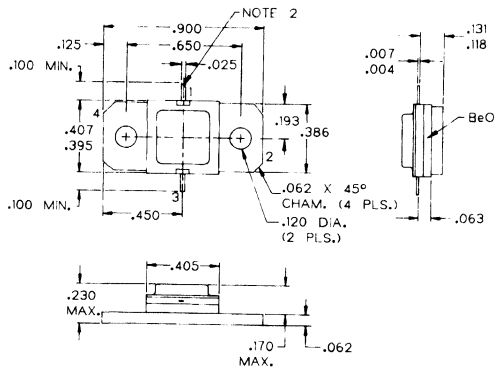
### TEST CIRCUIT





PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J113214F



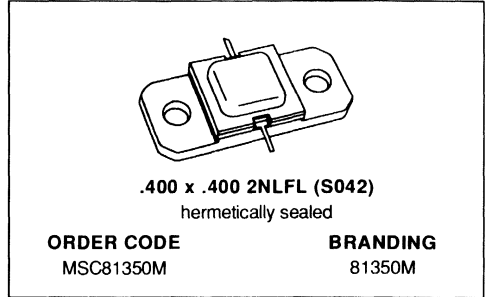
NOTES:

1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD SLANT CUT.



**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

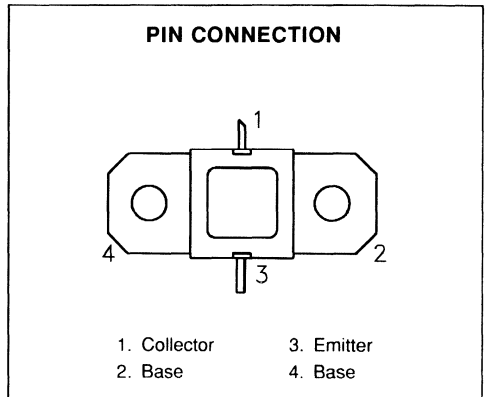
- REFRACTORY/GOLD METALLIZATION
- RUGGEDIZED VSWR 20:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 350 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$


**DESCRIPTION**

The MSC81350M device is a high power pulsed transistor specifically designed for IFF avionics applications.

This device is capable of withstanding a minimum 20:1 load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81350M is housed in the unique AMPAC™ package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 55^{\circ}\text{C}$ )	720	W
$I_C$	Device Current*	19.8	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.20	$^{\circ}\text{C/W}$
---------------	-----------------------------------	------	----------------------

\*Applies only to rated RF amplifier operation

# MSC81350M

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V	
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V	
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	65	—	—	V	
$I_{CES}$	$V_{CE} = 50V$		—	—	25	mA	
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	120	—	

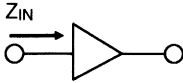
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090 MHz$	$P_{IN} = 70 W$	$V_{CC} = 50 V$	350	360	—	W
$\eta_C$	$f = 1090 MHz$	$P_{IN} = 70 W$	$V_{CC} = 50 V$	40	44	—	%
$G_P$	$f = 1090 MHz$	$P_{IN} = 70 W$	$V_{CC} = 50 V$	7.0	7.1	—	dB

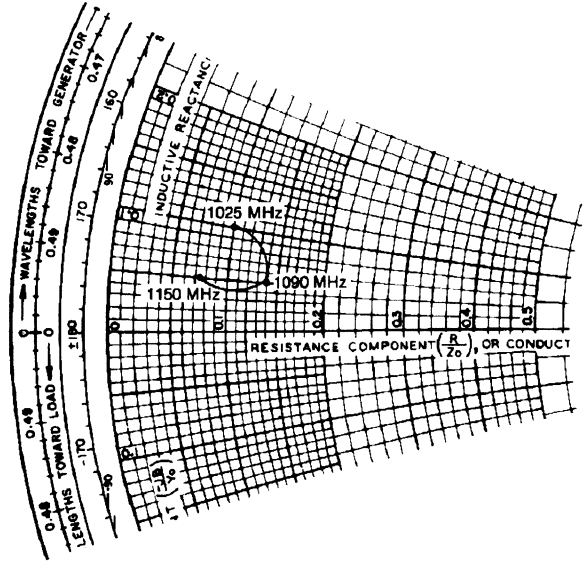
Note: Pulse Width =  $10\mu Sec$   
Duty Cycle = 1%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

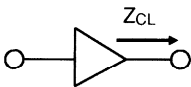


$P_{IN} = 70\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms

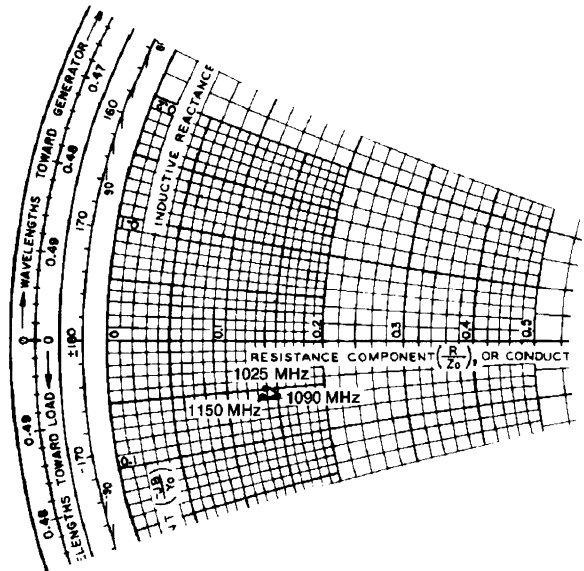


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1025 MHz	$5.0 + j 5.0$	$7.0 - j 2.5$
M = 1090 MHz	$7.0 + j 2.5$	$7.5 - j 2.8$
H = 1150 MHz	$3.6 + j 2.5$	$6.8 - j 2.7$

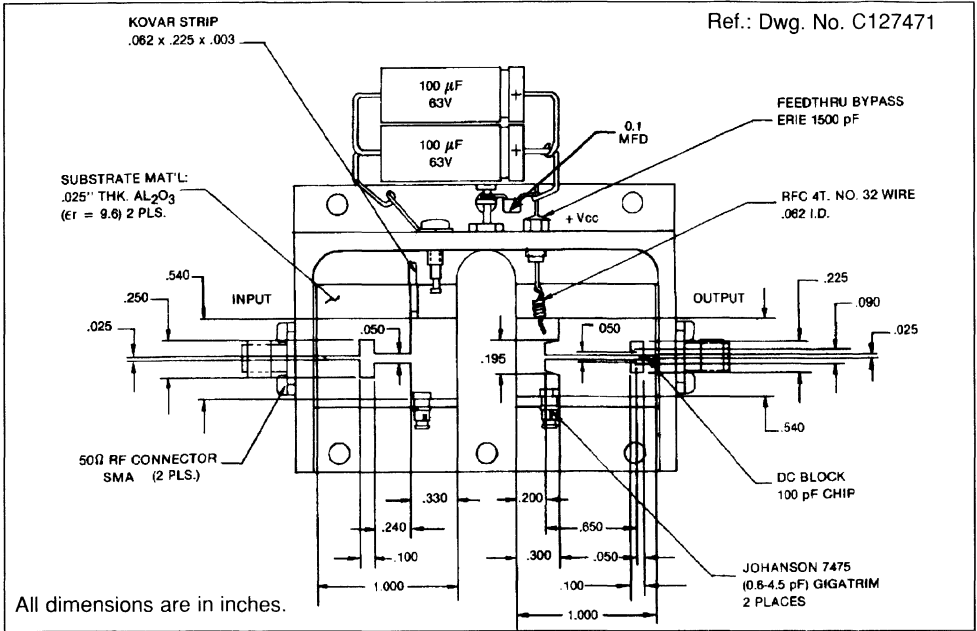
TYPICAL COLLECTOR LOAD IMPEDANCE



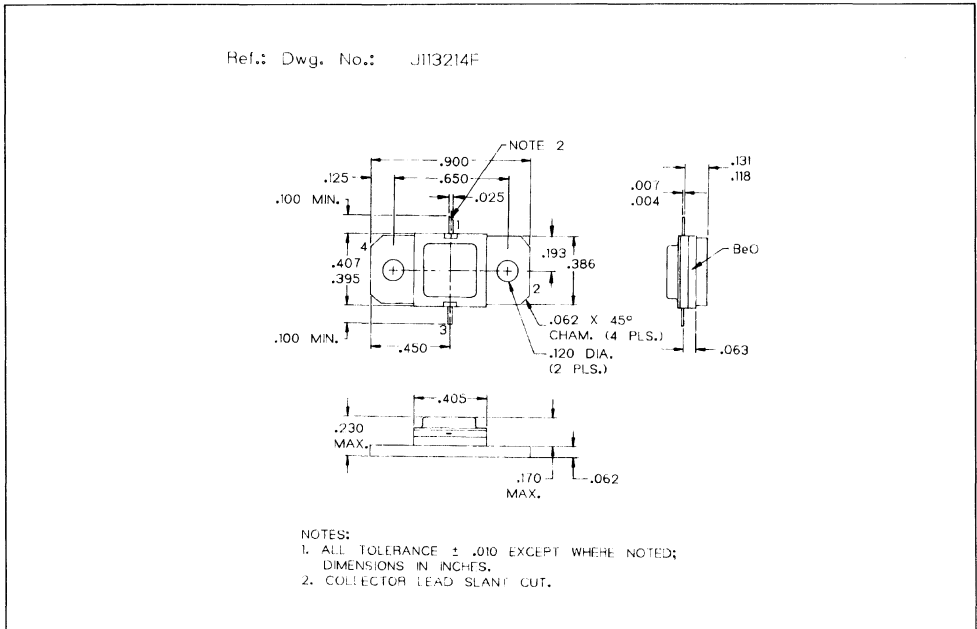
$P_{IN} = 70\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms



TEST CIRCUIT

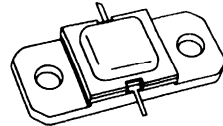


PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- RUGGEDIZED VSWR 20:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 390$  W MIN. WITH 6.8 dB GAIN



**.400 x .400 2NLF (S042)**  
 hermetically sealed

**ORDER CODE**  
 MSC81390M

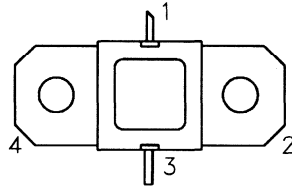
**BRANDING**  
 81390M

**DESCRIPTION**

The MSC81390M transistor is a high peak pulse power device specifically designed for IFF avionics applications.

This device is capable of withstanding any mismatch load condition at any phase angle under full rated conditions.

The MSC81390M is housed in the unique AMPAC™ hermetic metal/ceramic package with internal input/output matching structures.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 100^{\circ}C$ )	1000	W
$I_c$	Device Current*	28	A
$V_{CC}$	Collector-Supply Voltage*	50	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.15	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

# MSC81390M

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

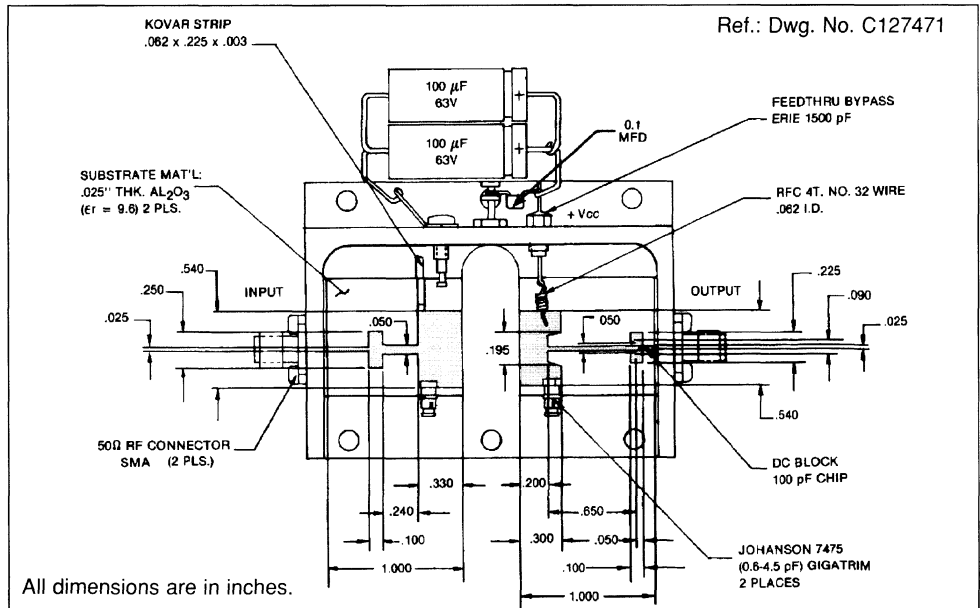
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 15mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 50mA	R <sub>BE</sub> = 10Ω	65	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 65V		—	—	35	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	15	—	120	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1090 MHz	P <sub>IN</sub> = 80 W	V <sub>CC</sub> = 50 V	390	—	—	W
η <sub>C</sub>	f = 1090 MHz	P <sub>IN</sub> = 80 W	V <sub>CC</sub> = 50 V	35	—	—	%
G <sub>P</sub>	f = 1090 MHz	P <sub>IN</sub> = 80 W	V <sub>CC</sub> = 50 V	6.8	—	—	dB

Note: Pulse Width = 10μSec  
Duty Cycle = 1%

### TEST CIRCUIT



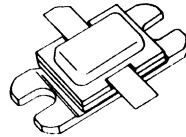






## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- RUGGEDIZED VSWR 25:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 400 \text{ W MIN. WITH } 6.5 \text{ dB GAIN}$



**.400 x .500 2LFL (S038)**  
hermetically sealed

**ORDER CODE**  
MSC81400M

**BRANDING**  
81400M

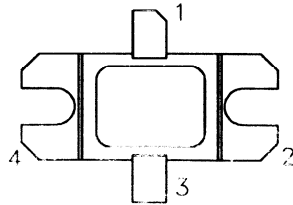
### DESCRIPTION

The MSC81400M "Super Power" transistor is a high peak pulse power device specifically designed for DME/TACAN avionics applications.

This device is capable of withstanding a minimum 25:1 load mismatch condition at any phase angle under full rated conditions.

The MSC81400M is housed in the unique BIGPAC™ hermetic metal/ceramic package with internal input/output matching structures

### PIN CONNECTION



- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 80^{\circ}\text{C}$ )	1000	W
$I_C$	Device Current*	28	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.12	$^{\circ}\text{C/W}$
---------------	-----------------------------------	------	----------------------

\*Applies only to rated RF amplifier operation

# MSC81400M

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

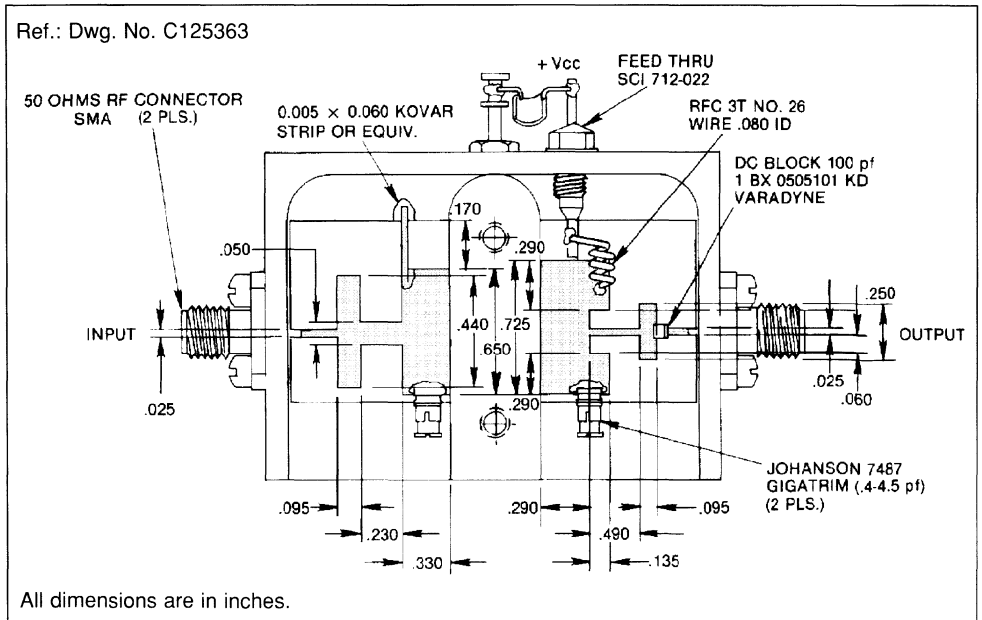
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 15mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 50mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	35	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	120	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150$ MHz	$P_{IN} = 90$ W	$V_{CC} = 50$ V	400	450	—	W
$\eta_c$	$f = 1025 - 1150$ MHz	$P_{IN} = 90$ W	$V_{CC} = 50$ V	40	—	—	%
GP	$f = 1025 - 1150$ MHz	$P_{IN} = 90$ W	$V_{CC} = 50$ V	6.5	—	—	dB

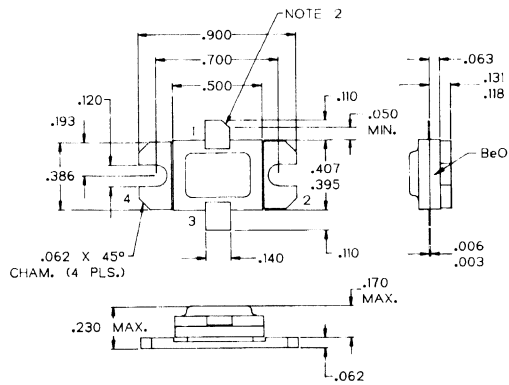
Note: Pulse Width =  $10\mu Sec$   
 Duty Cycle = 1%

### TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F

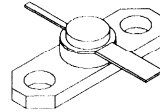




## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIERS APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- HIGH GAIN & COLLECTOR EFFICIENCY
- RUGGED OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 2.0 \text{ W MIN. WITH } 10.0 \text{ dB GAIN}$



**.250 2LFL (S010)**  
hermetically sealed

**ORDER CODE**

MSC81402

**BRANDING**

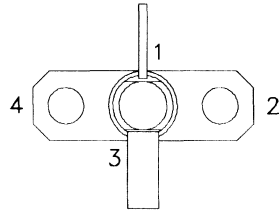
81402

### DESCRIPTION

The MSC81402 is a 28 Volt, Class C, common base NPN bipolar device designed for general purpose amplifier applications in the UHF and L-Band frequency range.

High gain and collector efficiency along with extreme ruggedness are obtained using a gold metallized emitter-ballasted overlay die geometry.

### PIN CONNECTION



1. Collector  
2. Base

3. Emitter  
4. Base

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}\text{C}$ )	6	W
$I_C$	Device Current*	0.23	A
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	25	$^{\circ}\text{C/W}$
---------------	-----------------------------------	----	----------------------

\*Applies only to rated RF amplifier operation

# MSC81402

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

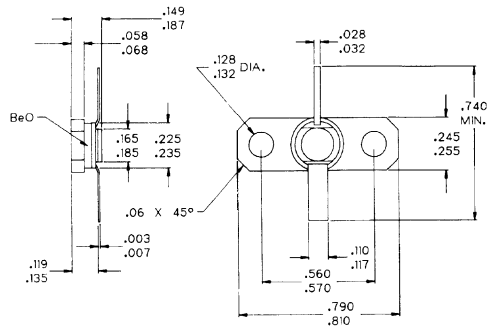
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	50	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	50	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	30	—	300	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.4 GHz$	$P_{IN} = 0.2W$	$V_{CC} = 28V$	2.0	—	—	W
$\eta_C$	$f = 1.4 GHz$	$P_{IN} = 0.2W$	$V_{CC} = 28V$	50	—	—	%
$G_P$	$f = 1.4 GHz$	$P_{IN} = 0.2W$	$V_{CC} = 28V$	10.0	—	—	dB
$C_{OB}$	$f = 1MHz$	$V_{CB} = 28V$		—	3.2	—	pF

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C



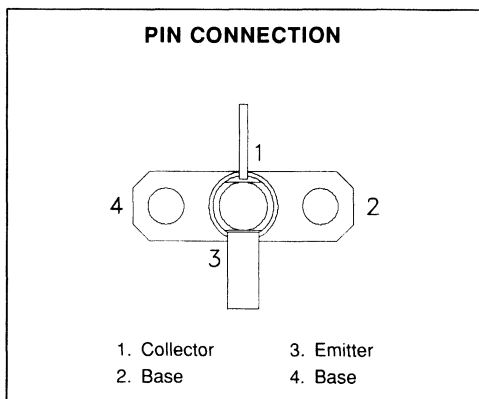
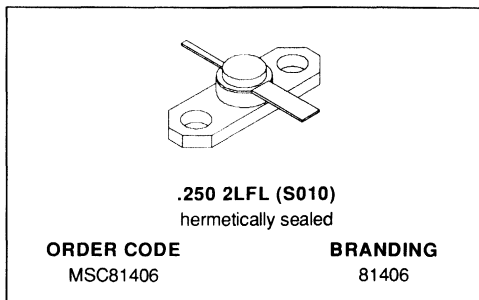
NOTES:  
 1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
 DIMENSIONS IN INCHES.



## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIERS APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- HIGH GAIN & COLLECTOR EFFICIENCY
- RUGGED OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 6.0$  W MIN. WITH 9.7 dB GAIN



### DESCRIPTION

The MSC81406 is a 28 Volt, Class C, common base NPN bipolar device designed for general purpose amplifier applications in the UHF and L-Band frequency range.

High gain and collector efficiency along with extreme ruggedness are obtained using a gold metallized emitter-ballasted overlay die geometry.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	15	W
$I_C$	Device Current*	0.6	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	10	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

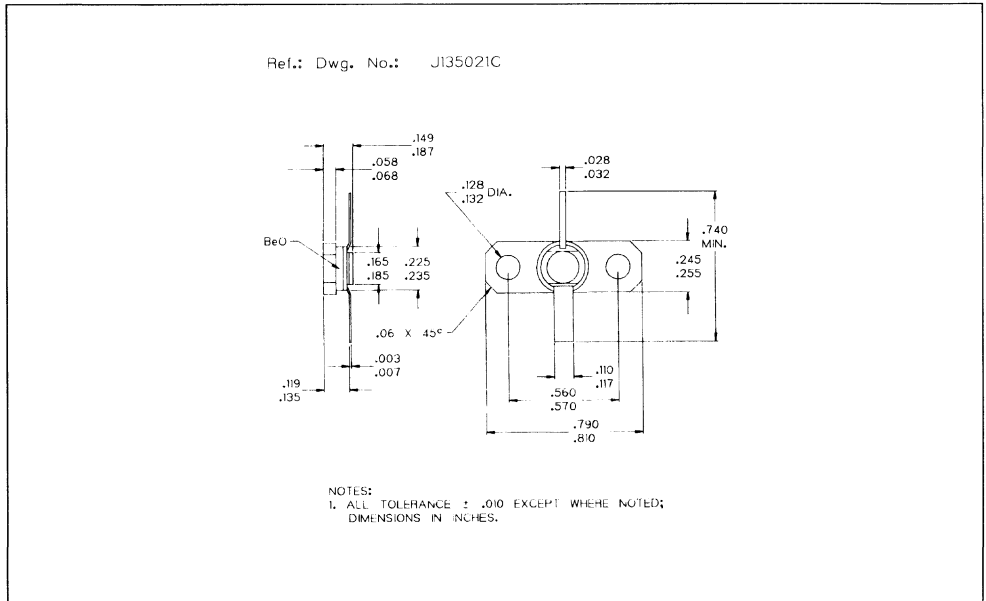
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	55	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 5mA	R <sub>BE</sub> = 10Ω	55	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	1.0	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 250mA	20	—	300	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1.4 GHz	P <sub>IN</sub> = 0.65W	V <sub>CC</sub> = 28V	6.0	—	—	W
η <sub>c</sub>	f = 1.4 GHz	P <sub>IN</sub> = 0.65W	V <sub>CC</sub> = 28V	45	—	—	%
G <sub>P</sub>	f = 1.4 GHz	P <sub>IN</sub> = 0.65W	V <sub>CC</sub> = 28V	9.7	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28V		—	—	6.0	pF

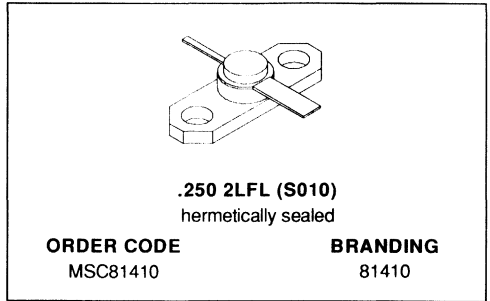
PACKAGE MECHANICAL DATA



## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIERS APPLICATIONS

PRELIMINARY DATA

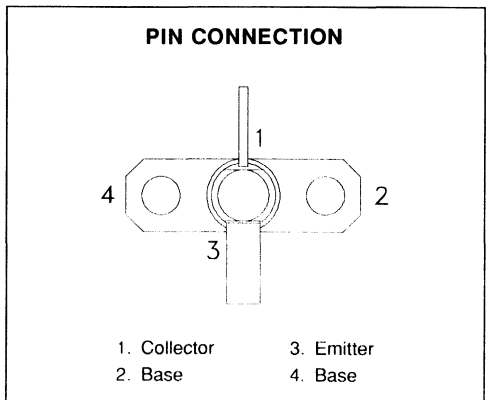
- REFRACTORY\GOLD METALLIZATION
- HIGH GAIN & COLLECTOR EFFICIENCY
- RUGGED OVERLAY GEOMETRY
- METAL\CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 10$  W MIN. WITH 8.5 dB GAIN



### DESCRIPTION

The MSC81410 is a 28 Volt, Class C, common base NPN bipolar device designed for general purpose amplifier applications in the UHF and L-Band frequency range.

High gain and collector efficiency along with extreme ruggedness are obtained using a gold metallized emitter-ballasted overlay die geometry.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	25	W
$I_C$	Device Current*	1.0	A
$V_{CC}$	Collector-Supply Voltage*	28	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	6.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

# MSC81410

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

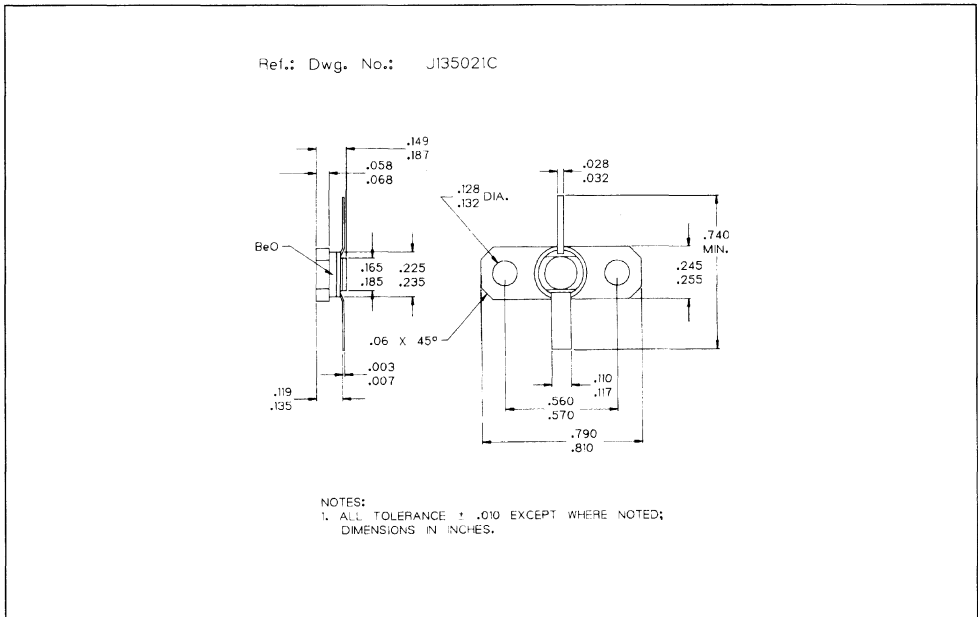
### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 10mA	I <sub>E</sub> = 0mA	55	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 2mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 10mA	R <sub>BE</sub> = 10Ω	55	—	—	V
I <sub>CES</sub>	V <sub>BE</sub> = 0V	V <sub>CE</sub> = 28V	—	—	2.0	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500mA	20	—	300	—

### DYNAMIC

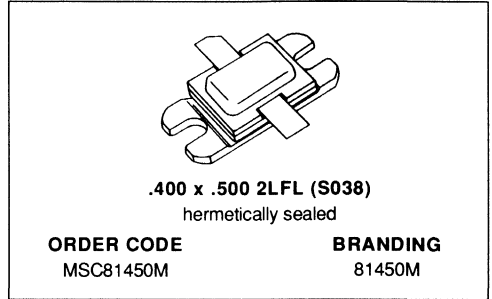
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1.4 GHz	P <sub>IN</sub> = 1.4 W	V <sub>CC</sub> = 28 V	10	—	—	W
η <sub>C</sub>	f = 1.4 GHz	P <sub>IN</sub> = 1.4 W	V <sub>CC</sub> = 28 V	45	—	—	%
G <sub>P</sub>	f = 1.4 GHz	P <sub>IN</sub> = 1.4 W	V <sub>CC</sub> = 28 V	8.5	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	9.5	pF

## PACKAGE MECHANICAL DATA



**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

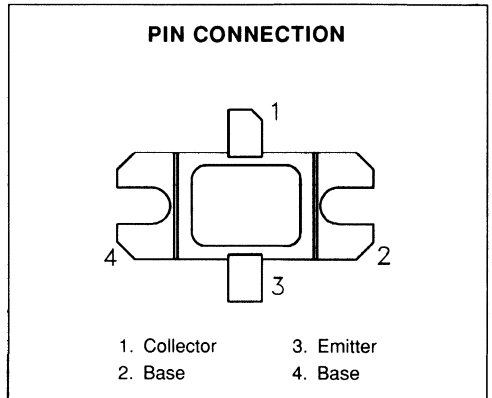
- REFRACTORY/GOLD METALLIZATION
- RUGGEDIZED VSWR 25:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 450$  W MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

The MSC81450M device is a high power pulsed transistor specifically designed for IFF avionics applications.

This device is capable of withstanding a minimum 25:1 load mismatch at any phase angle under full rated conditions.

The MSC81450M is housed in the unique BIGPAC™ package with internal input/output matching structures.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	910	W
$I_C$	Device Current*	28	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.15	$^{\circ}C/W$
---------------	-----------------------------------	------	---------------

\*Applies only to rated RF amplifier operation

# MSC81450M

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

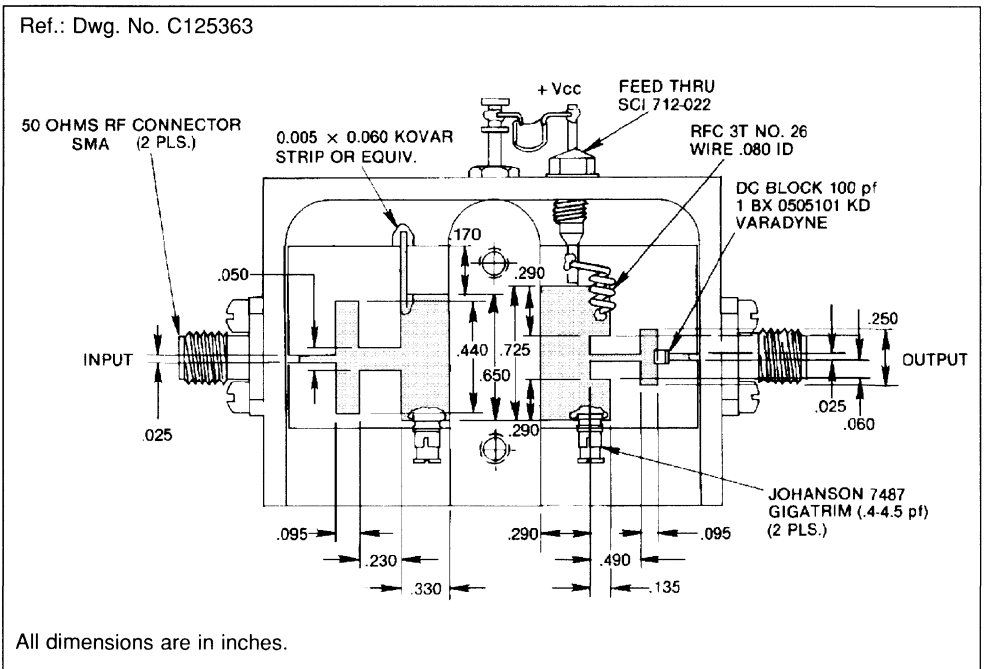
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 15mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 50mA	R <sub>BE</sub> = 10Ω	65	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 50V		—	—	35	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	15	—	120	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1090 MHz	P <sub>IN</sub> = 90 W	V <sub>CC</sub> = 50 V	450	500	—	W
η <sub>c</sub>	f = 1090 MHz	P <sub>IN</sub> = 90 W	V <sub>CC</sub> = 50 V	40	—	—	%
GP	f = 1090 MHz	P <sub>IN</sub> = 90 W	V <sub>CC</sub> = 50 V	7.0	—	—	dB

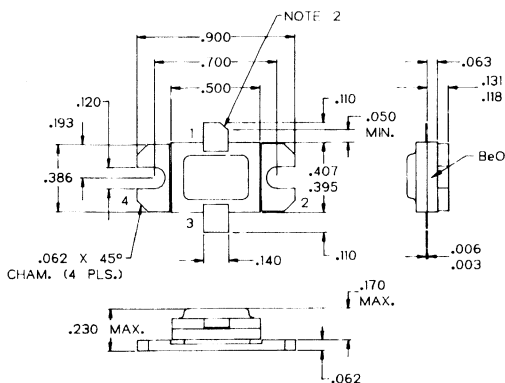
Note: Pulse Width = 10μSec  
Duty Cycle = 1%

### TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F



NOTES:

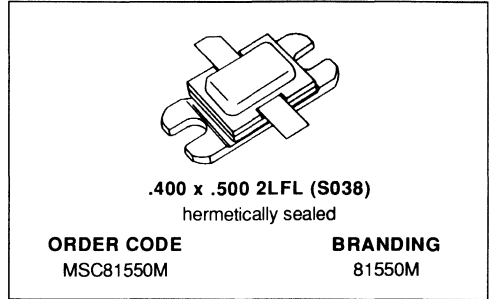
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.





## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- VSWR CAPABILITY 25:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 550 W MIN. WITH 5.6 dB GAIN

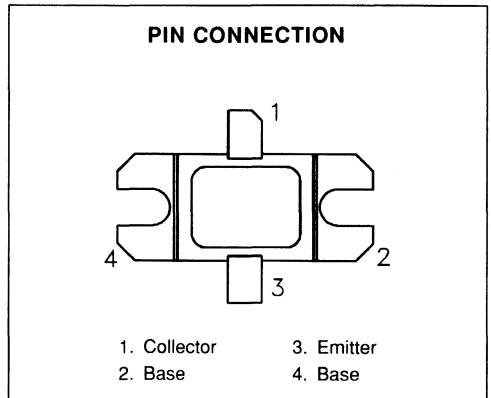


### DESCRIPTION

The MSC81550M device is a high power pulsed transistor specifically designed for DME/TACAN avionics applications.

This device is capable of withstanding a minimum 25:1 load mismatch condition at any phase angle under full rated conditions.

The MSC81550M is housed in the unique BIGPAC™ package with internal input/output matching structures.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 80°C)	1350	W
I <sub>C</sub>	Device Current*	40	A
V <sub>CC</sub>	Collector-Supply Voltage*	55	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.09	°C/W
----------------------	-----------------------------------	------	------

\*Applies only to rated RF amplifier operation

# MSC81550M

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

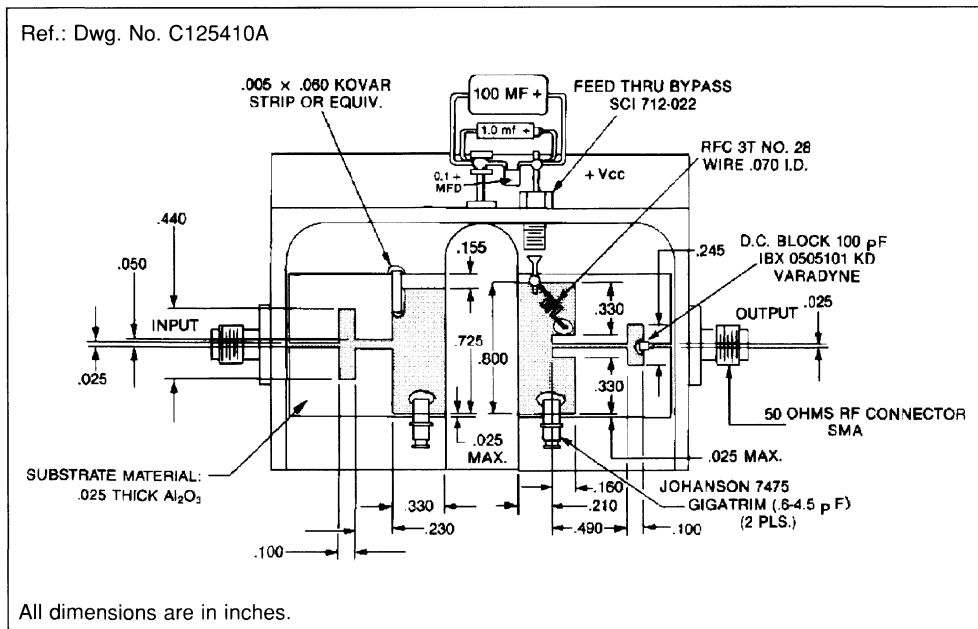
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CB0</sub>	I <sub>C</sub> = 25mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 50mA	R <sub>BE</sub> = 10Ω	65	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 50V		—	—	60	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 2A	10	—	250	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1025 — 1150 MHz	P <sub>IN</sub> = 150 W	V <sub>CC</sub> = 50 V	550	600	—	W
η <sub>C</sub>	f = 1025 — 1150 MHz	P <sub>IN</sub> = 150 W	V <sub>CC</sub> = 50 V	35	38	—	%
G <sub>P</sub>	f = 1025 — 1150 MHz	P <sub>IN</sub> = 150 W	V <sub>CC</sub> = 50 V	5.6	—	—	dB

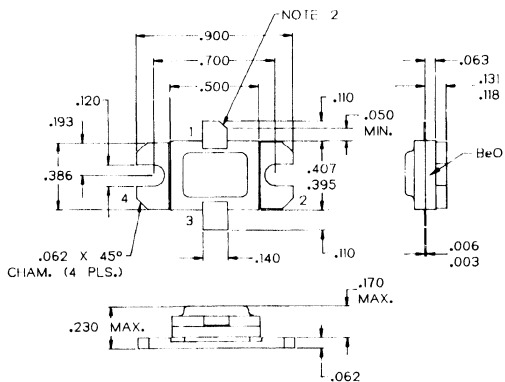
Note: Pulse Width = 10μSec  
 Duty Cycle = 1%

### TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F



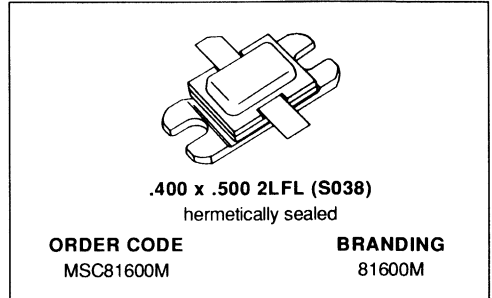
NOTES:

1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- 25:1 VSWR CAPABILITY @ RATED CONDITIONS
- INPUT MATCHING
- OVERLAY GEOMETRY
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 600\text{ W MIN. WITH } 6.0\text{ dB GAIN}$

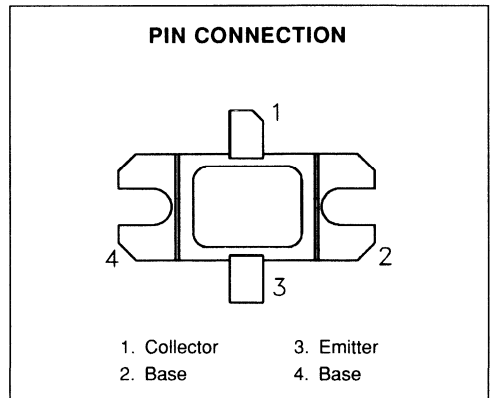


### DESCRIPTION

The MSC81600M device is a high power pulsed transistor specifically designed for IFF avionics applications.

This device is designed for operation under short pulse width and low duty cycle pulse conditions and is capable of withstanding a minimum 25:1 load mismatch at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81600M is supplied in the BIGPAC™ hermetic metal/ceramic package with internal input matching.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 100^{\circ}\text{C}$ )	1670	W
$I_C$	Device Current*	43	A
$V_{CC}$	Collector-Supply Voltage*	55	V
$T_J$	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.09	$^{\circ}\text{C/W}$
---------------	-----------------------------------	------	----------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 50mA$	$R_{BE} = 10\Omega$	65	—	—	V
$I_{CES}$	$V_{CE} = 50V$		—	—	60	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	10	—	250	—

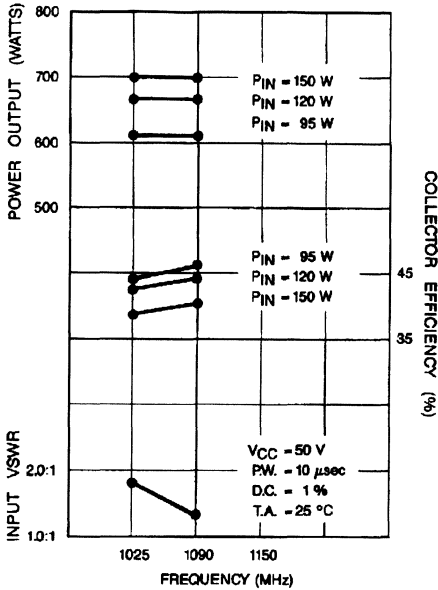
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090\text{ MHz}$	$P_{IN} = 150\text{ W}$	$V_{CC} = 50\text{ V}$	600	700	—	W
$\eta_c$	$f = 1090\text{ MHz}$	$P_{IN} = 150\text{ W}$	$V_{CC} = 50\text{ V}$	35	40	—	%
$G_P$	$f = 1090\text{ MHz}$	$P_{IN} = 150\text{ W}$	$V_{CC} = 50\text{ V}$	6.0	6.7	—	dB

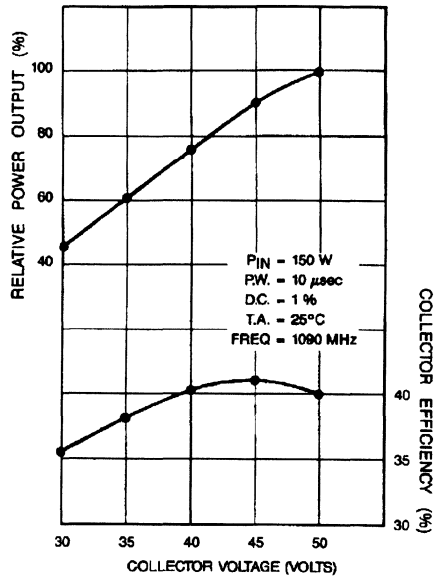
Note: Pulse Width = 10 $\mu$ Sec  
 Duty Cycle = 1%

TYPICAL PERFORMANCE

NARROWBAND POWER AMPLIFIER



RELATIVE POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE

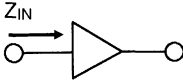


MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH & DUTY CYCLE

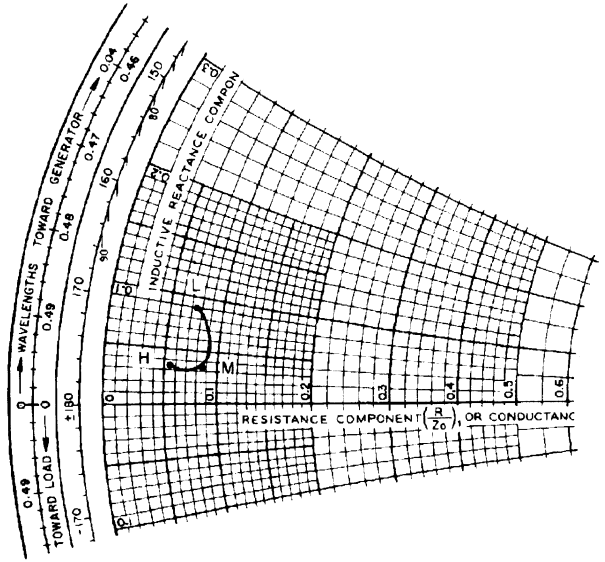


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

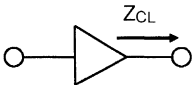


$P_{IN} = 150\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms

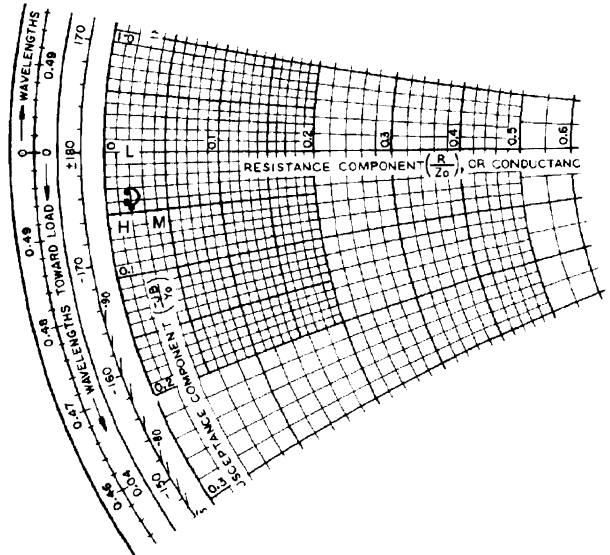


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
L = 1025 MHz	$3.7 + j 4.5$	$0.9 - j 1.6$
M = 1090 MHz	$4.3 + j 1.6$	$1.0 - j 2.3$
H = 1150 MHz	$2.8 + j 1.6$	$0.8 - j 2.0$

TYPICAL COLLECTOR LOAD IMPEDANCE



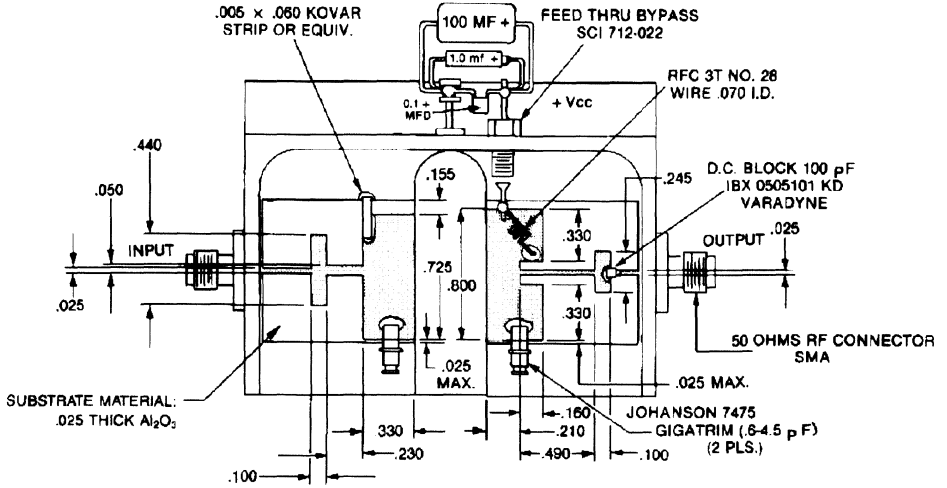
$P_{IN} = 150\text{ W}$   
 $V_{CC} = 50\text{ V}$   
 Normalized to 50 ohms





TEST CIRCUIT

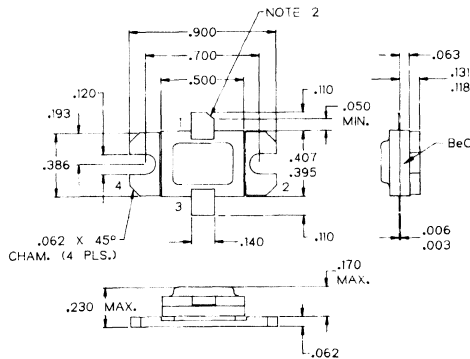
Ref.: Dwg. No. C125410



All dimensions are in inches.

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F



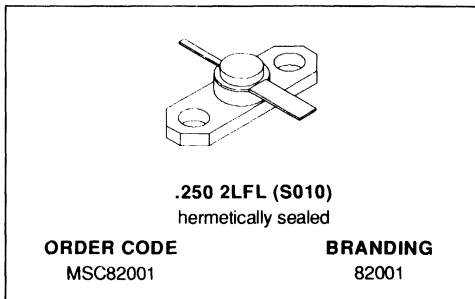
NOTES:

1. ALL TOLERANCE ± .010 EXCEPT WHERE NOTED; DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.



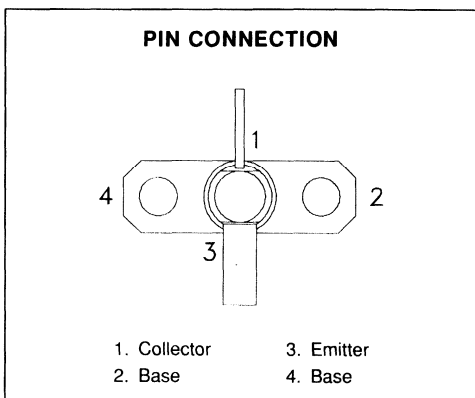
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- EMITTER BALLASTED
- REFRACTORY/GOLD METALLIZATION
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 1.0$  W MIN. WITH 7.0 dB GAIN @ 2.0 GHz



### DESCRIPTION

The MSC82001 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC82001 was designed for Class C amplifier applications in the 1.0 - 2.0 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	7.0	W
$I_c$	Device Current*	200	mA
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	20	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

STATIC

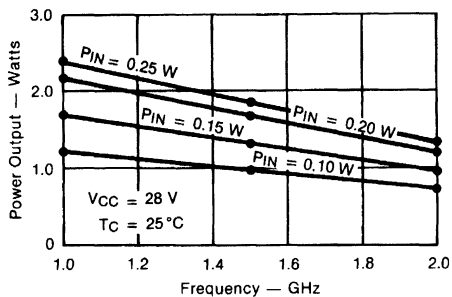
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

DYNAMIC

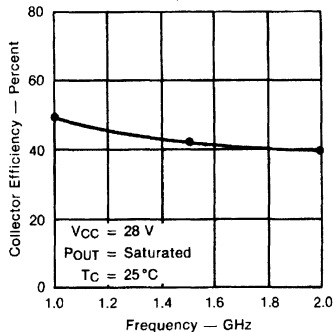
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.0\text{ GHz}$	$P_{IN} = 0.2\text{ W}$	$V_{CC} = 28\text{ V}$	1.0	1.2	—	W
$\eta_C$	$f = 2.0\text{ GHz}$	$P_{IN} = 0.2\text{ W}$	$V_{CC} = 28\text{ V}$	35	40	—	%
$G_P$	$f = 2.0\text{ GHz}$	$P_{IN} = 0.2\text{ W}$	$V_{CC} = 28\text{ V}$	7.0	7.8	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	3.2	pF

TYPICAL PERFORMANCE

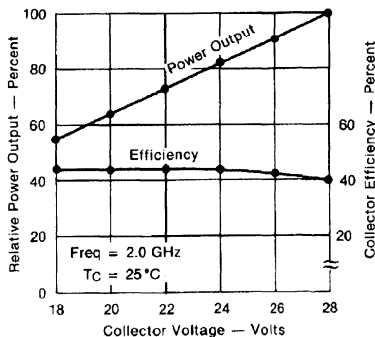
POWER OUTPUT vs FREQUENCY



COLLECTOR EFFICIENCY vs FREQUENCY

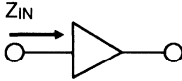


RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE

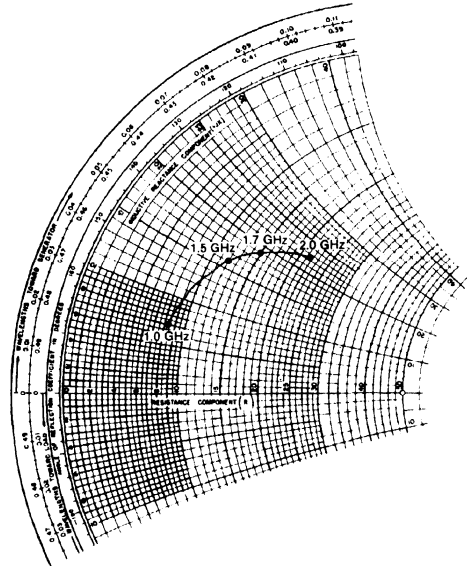


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

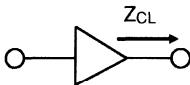


$P_{IN} = 0.2 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 Normalized to 50 ohms

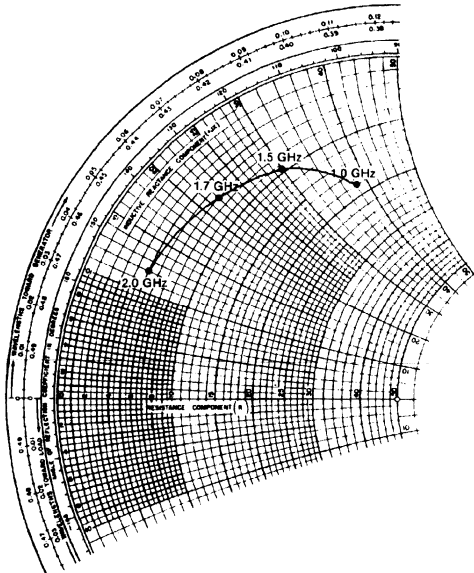


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
1.0 GHz	$8.3 + j 7.0$	$18.0 + j 38.0$
1.5 GHz	$12.0 + j 16.0$	$9.6 + j 30.0$
1.7 GHz	$15.0 + j 14.0$	$7.0 + j 22.0$
2.0 GHz	$21.5 + j 22.5$	$5.0 + j 12.0$

TYPICAL COLLECTOR LOAD IMPEDANCE



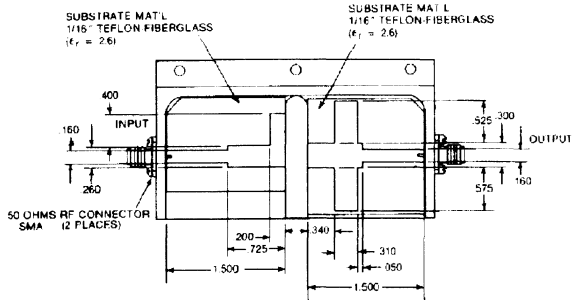
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28 \text{ V}$   
 Normalized to 50 ohms



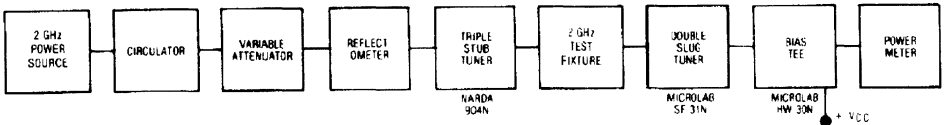
TEST CIRCUIT

Ref.: Dwg. No. C127

All dimensions are in inches.  
Frequency 2.0 GHz

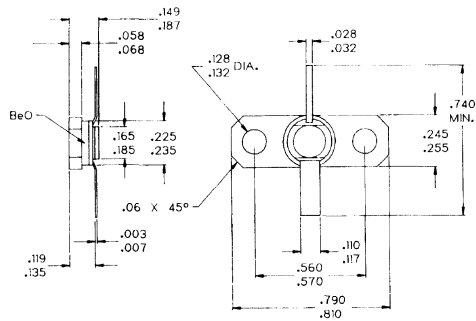


RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

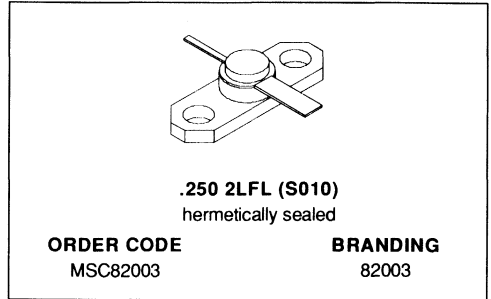
Ref.: Dwg. No.: J135021C



NOTES:  
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

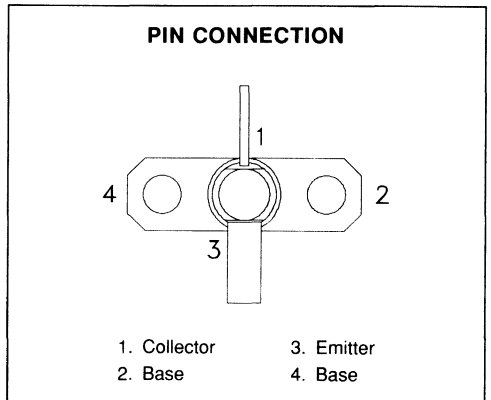
**RF & MICROWAVE TRANSISTORS  
GENERAL PURPOSE AMPLIFIER APPLICATIONS**

- EMITTER BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- REFRACTORY/GOLD METALLIZATION
- HERMETIC STRIPAC<sup>®</sup> PACKAGE
- $P_{OUT} = 3.0$  W MIN. WITH 7.8 dB GAIN @ 2.0 GHz



**DESCRIPTION**

The MSC82003 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC82003 was designed for Class C amplifier applications in the 1.0 - 2.0 GHz frequency range.



**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	21.8	W
$I_C$	Device Current*	600	mA
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	8.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

STATIC

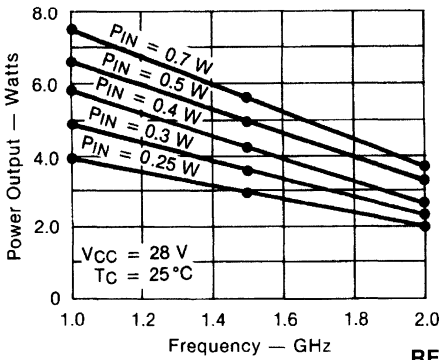
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 200mA$	15	—	120	—

DYNAMIC

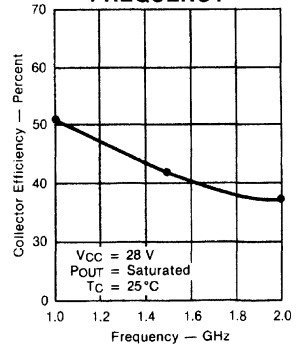
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.0\text{ GHz}$	$P_{IN} = 0.5\text{ W}$	$V_{CC} = 28\text{ V}$	3.0	3.3	—	W
$\eta_C$	$f = 2.0\text{ GHz}$	$P_{IN} = 0.5\text{ W}$	$V_{CC} = 28\text{ V}$	35	37	—	%
$G_P$	$f = 2.0\text{ GHz}$	$P_{IN} = 0.5\text{ W}$	$V_{CC} = 28\text{ V}$	7.8	8.2	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	6.5	pF

TYPICAL PERFORMANCE

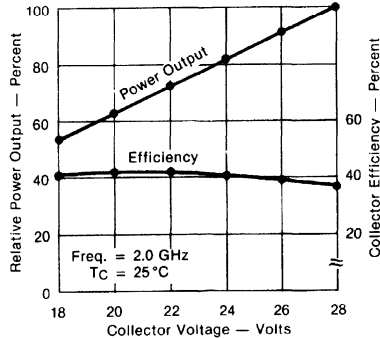
POWER OUTPUT vs FREQUENCY



COLLECTOR EFFICIENCY vs FREQUENCY



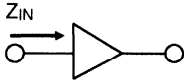
RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE



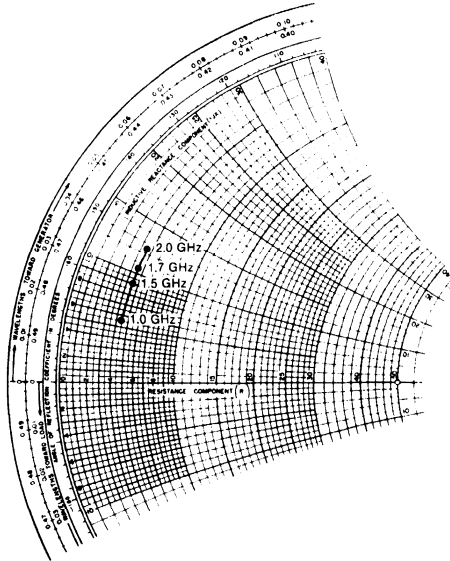


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

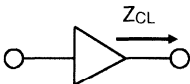


$P_{IN} = 0.5 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 Normalized to 50 ohms

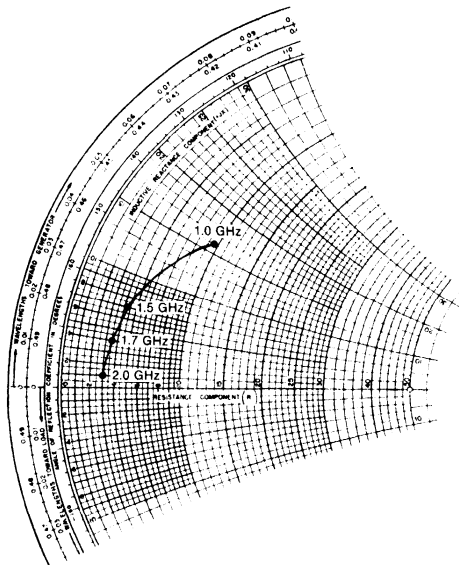


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
1.0 GHz	$4.4 + j 5.5$	$9.6 + j 16.0$
1.5 GHz	$4.5 + j 9.0$	$4.3 + j 7.0$
1.7 GHz	$4.5 + j 10.5$	$3.5 + j 4.0$
2.0 GHz	$4.6 + j 12.5$	$3.0 + j 1.0$

TYPICAL COLLECTOR LOAD IMPEDANCE



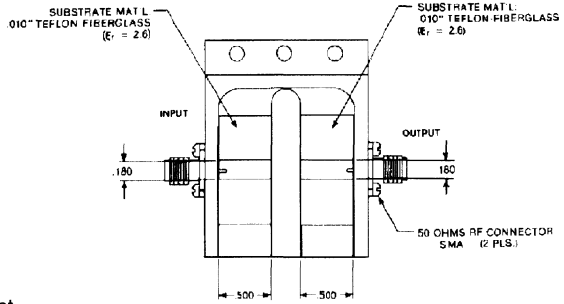
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28 \text{ V}$   
 Normalized to 50 ohms



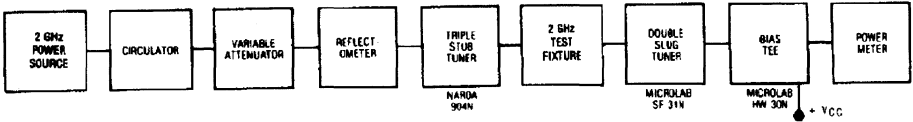
TEST CIRCUIT

Ref.: Dwg. No. C125518

All dimensions are in inches.  
Frequency 2.0 GHz

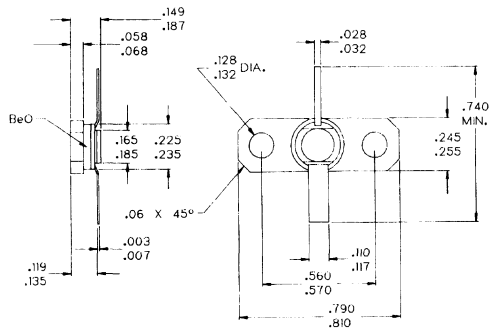


RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

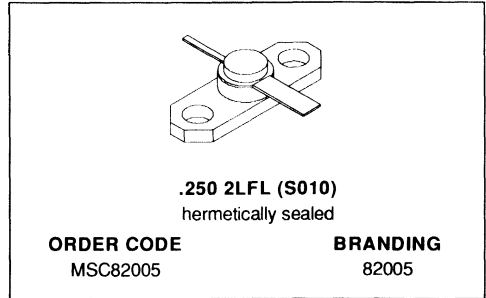
Ref.: Dwg. No.: J135021C



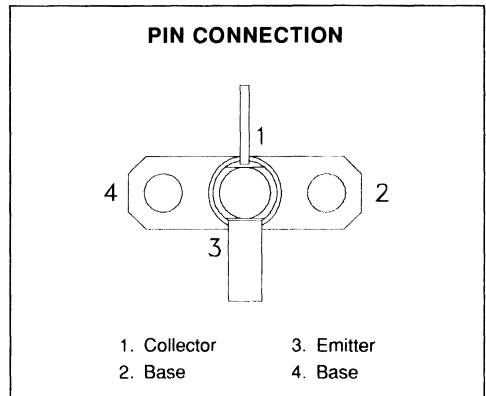
NOTES:  
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

**RF & MICROWAVE TRANSISTORS  
 GENERAL PURPOSE AMPLIFIER APPLICATIONS**

- EMITTER BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- REFRACTORY/GOLD METALLIZATION
- HERMETIC STRIPAC<sup>®</sup> PACKAGE
- $P_{OUT} = 5.0$  W MIN. WITH 7.0 dB GAIN @ 2.0 GHz


**DESCRIPTION**

The MSC82005 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC82005 was designed for Class C amplifier applications in the 1.0 - 2.0 GHz frequency range.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	29	W
$I_C$	Device Current*	1.0	A
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	6.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

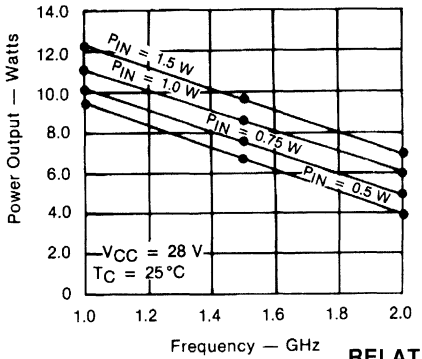
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	2.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	15	—	120	—

**DYNAMIC**

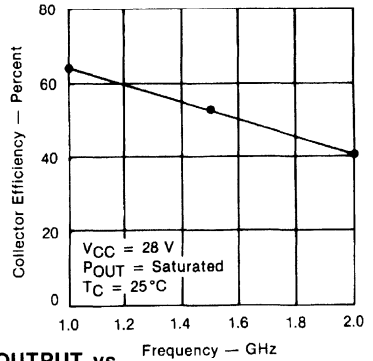
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.0\text{ GHz}$	$P_{IN} = 1.0\text{ W}$	$V_{CC} = 28\text{ V}$	5.0	6.0	—	W
$\eta_C$	$f = 2.0\text{ GHz}$	$P_{IN} = 1.0\text{ W}$	$V_{CC} = 28\text{ V}$	35	40	—	%
$G_P$	$f = 2.0\text{ GHz}$	$P_{IN} = 1.0\text{ W}$	$V_{CC} = 28\text{ V}$	7.0	7.8	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	10	pF

**TYPICAL PERFORMANCE**

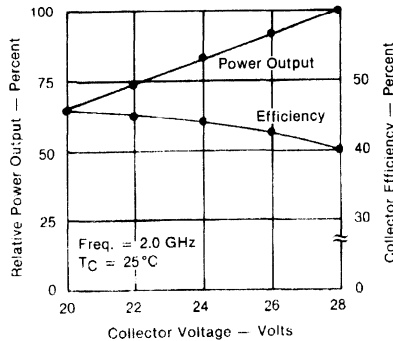
**POWER OUTPUT vs FREQUENCY**



**COLLECTOR EFFICIENCY vs FREQUENCY**

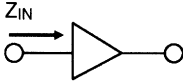


**RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE**

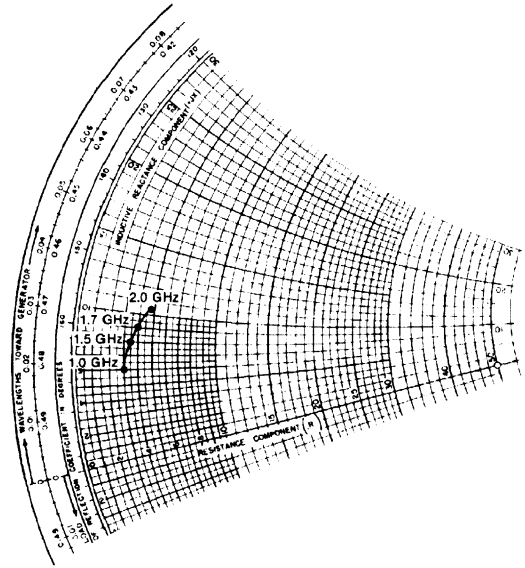


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

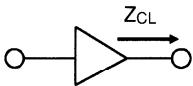


$P_{IN} = 1.0 \text{ W}$   
 $V_{CC} = 28 \text{ V}$   
 Normalized to 50 ohms

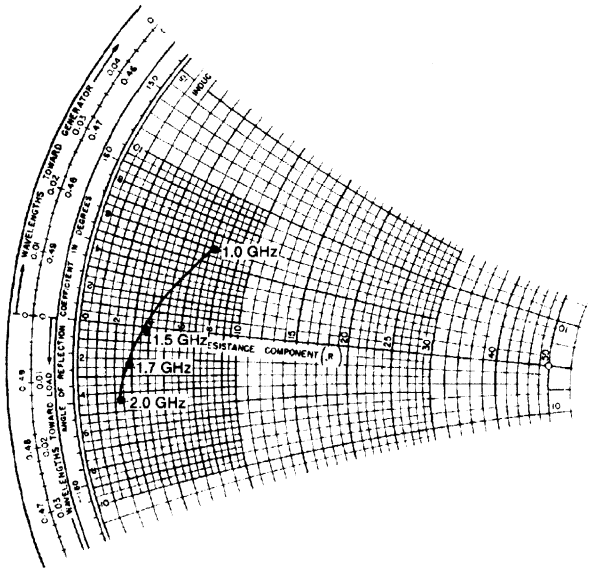


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
1.0 GHz	$3.0 + j 6.0$	$7.2 + j 6.0$
1.5 GHz	$3.5 + j 8.0$	$3.7 - j 0.2$
1.7 GHz	$4.0 + j 9.0$	$2.8 - j 2.3$
2.0 GHz	$4.8 + j 10.5$	$2.3 - j 4.5$

TYPICAL COLLECTOR LOAD IMPEDANCE



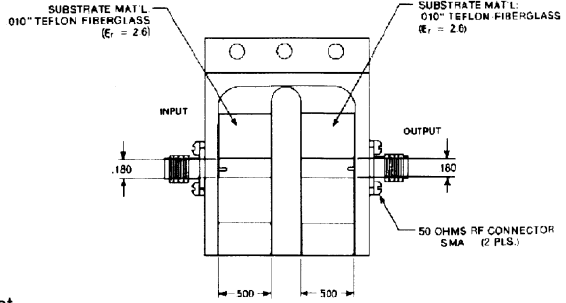
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28 \text{ V}$   
 Normalized to 50 ohms



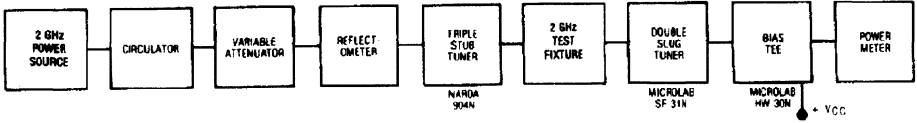
TEST CIRCUIT

Ref.: Dwg. No. C125518

All dimensions are in inches.  
Frequency 2.0 GHz

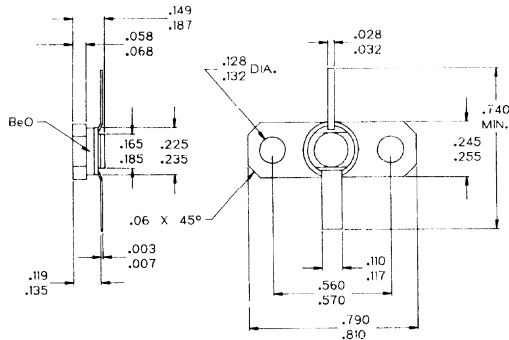


RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

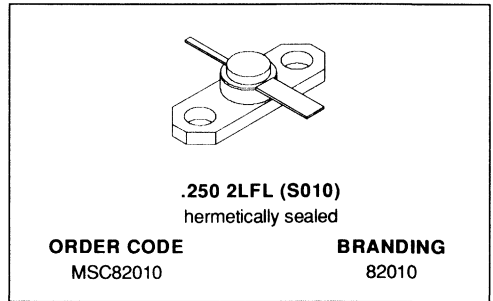
Ref.: Dwg. No.: J135021C



NOTES:  
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

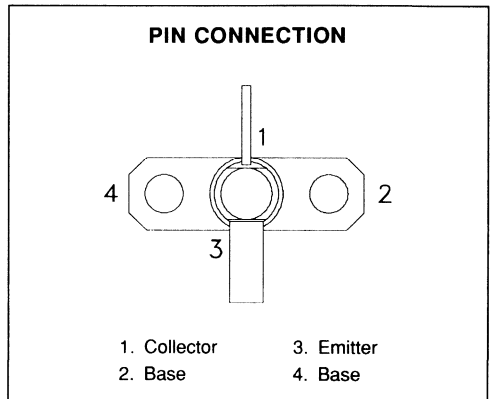
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- EMITTER BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC<sup>®</sup> PACKAGE
- $P_{OUT} = 10$  W MIN. WITH 5.2 dB GAIN @ 2.0 GHz



### DESCRIPTION

The MSC82010 is a common base hermetically sealed silicon NPN microwave transistor utilizing a fishbone emitter ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC82010 was designed for Class C amplifier applications in the 1.0 - 2.0 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation*	35	W
$I_C$	Device Current*	1.5	A
$V_{CC}$	Collector-Supply Voltage*	35	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	5.0	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

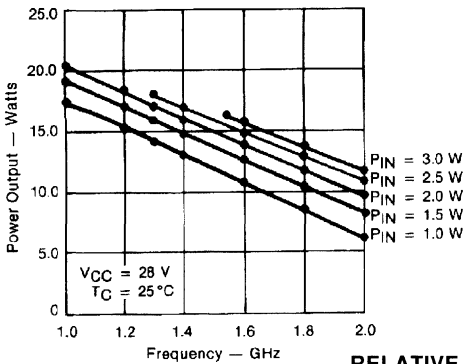
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 15mA	R <sub>BE</sub> = 10Ω	45	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	5.0	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1000mA	15	—	120	—

DYNAMIC

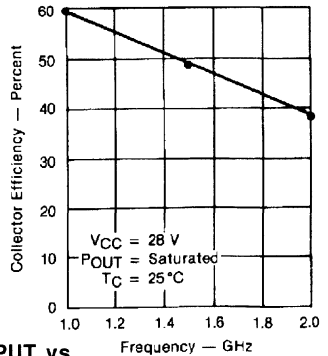
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2.0 GHz	P <sub>IN</sub> = 3.0 W	V <sub>CC</sub> = 28 V	10	11.5	—	W
η <sub>C</sub>	f = 2.0 GHz	P <sub>IN</sub> = 3.0 W	V <sub>CC</sub> = 28 V	35	38	—	%
G <sub>P</sub>	f = 2.0 GHz	P <sub>IN</sub> = 3.0 W	V <sub>CC</sub> = 28 V	5.2	5.8	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	19	pF

TYPICAL PERFORMANCE

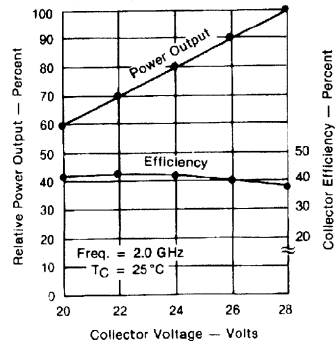
POWER OUTPUT vs FREQUENCY



COLLECTOR EFFICIENCY vs FREQUENCY



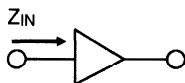
RELATIVE POWER OUTPUT vs COLLECTOR VOLTAGE



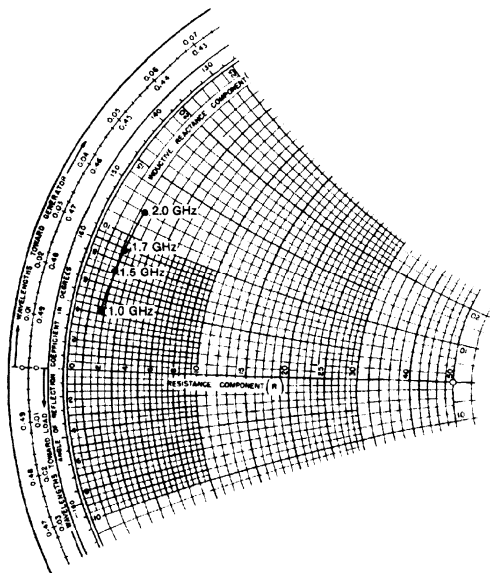


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

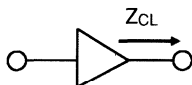


$P_{IN} = 3.0\text{ W}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms

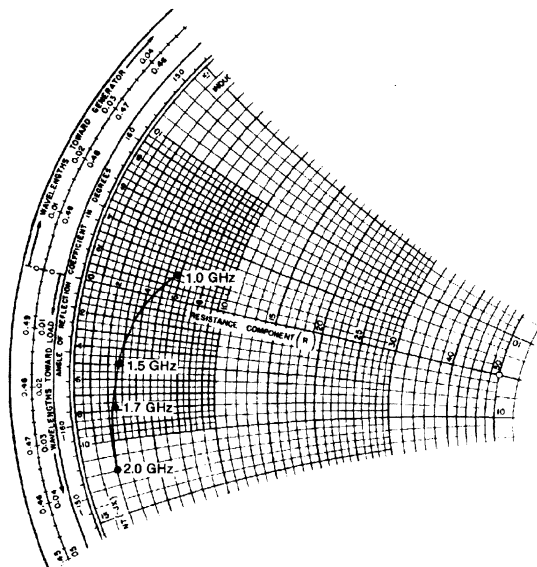


FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
1.0 GHz	$1.7 + j 4.2$	$5.7 + j 1.9$
1.5 GHz	$2.0 + j 7.2$	$2.8 - j 5.0$
1.7 GHz	$2.2 + j 8.8$	$2.5 - j 7.8$
2.0 GHz	$2.4 + j 12.0$	$2.0 - j 12.0$

TYPICAL COLLECTOR LOAD IMPEDANCE



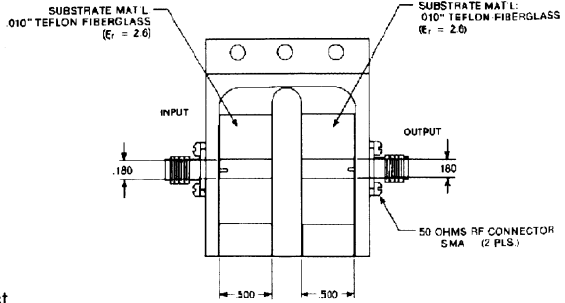
$P_{OUT} = \text{Saturated}$   
 $V_{CC} = 28\text{ V}$   
 Normalized to 50 ohms



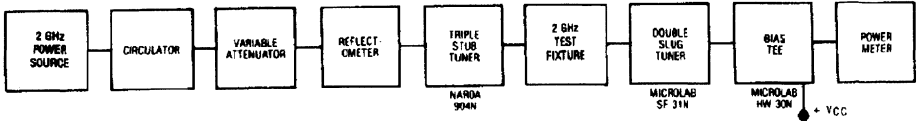
TEST CIRCUIT

Ref.: Dwg. No. C125518

All dimensions are in inches.  
Frequency 2.0 GHz

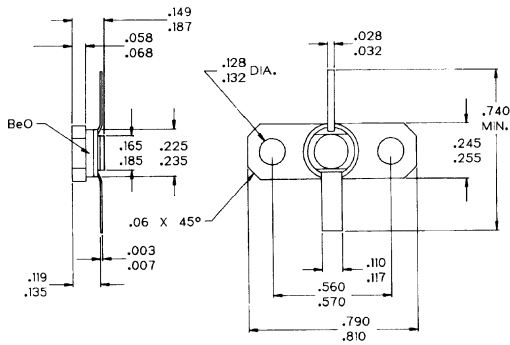


RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

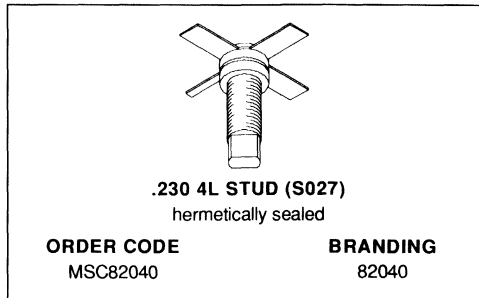
Ref.: Dwg. No.: JI35021C



NOTES:  
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

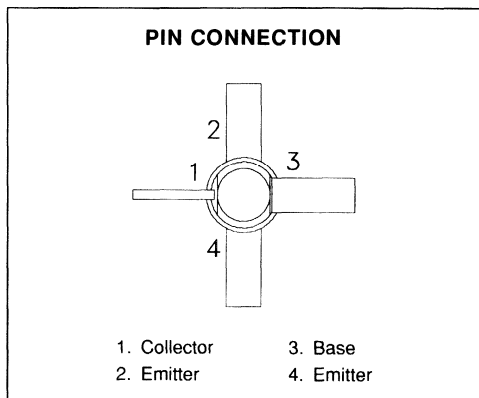
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- ft 1.6 GHz TYPICAL
- NOISE FIGURE 15.5 dB @ 2 GHz
- $P_{OUT} = 27$  dBm MIN. @ 1.0 GHz



### DESCRIPTION

The MSC82040 is a hermetically sealed NPN power transistor with a fishbone, emitter finger ballasted geometry utilizing a refractory/gold metallization system. The device is designed specifically for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation (see Safe Area)	—	W
$I_C$	Device Bias Current	200	mA
$V_{CE}$	Collector-Emitter Bias Voltage*	20	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	20	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	20	—	—	V
$I_{CEO}$	$V_{CE} = 18V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

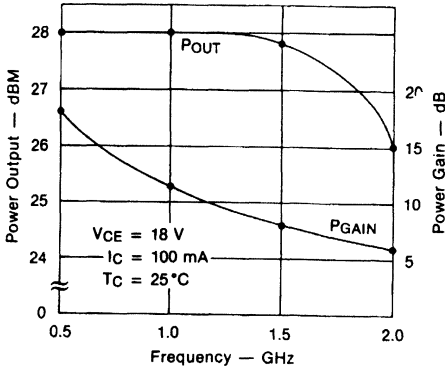
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$G_P^*$	$f = 1.0 GHz$	$P_{OUT} = 27 dBm$	10.5	11.5	—		dB
$\Delta G_P^*$	$f = 1.0 GHz$	$P_{OUT} = 27 dBm$	—	—	1		dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$	—	—	3.2		pF

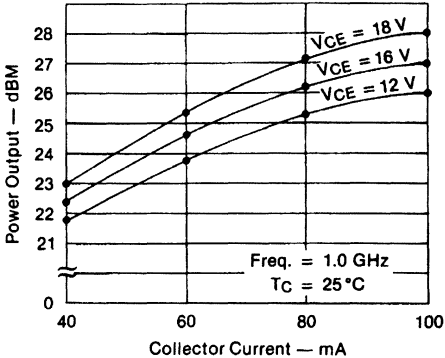
\* Note:  $V_{CE} = 18V$   
 $I_C = 100mA$

TYPICAL PERFORMANCE

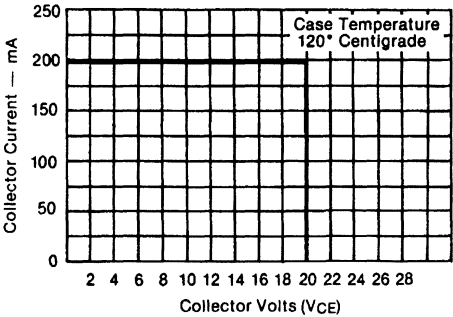
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs FREQUENCY



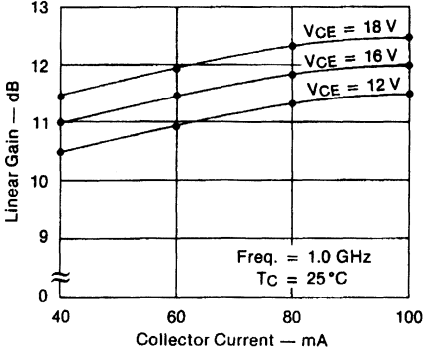
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



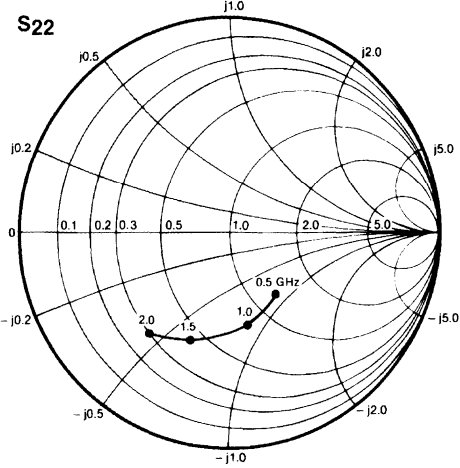
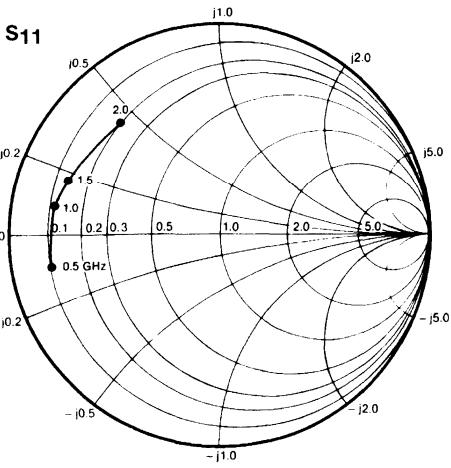
MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION



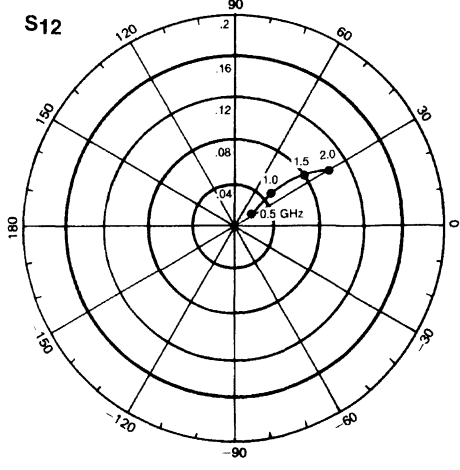
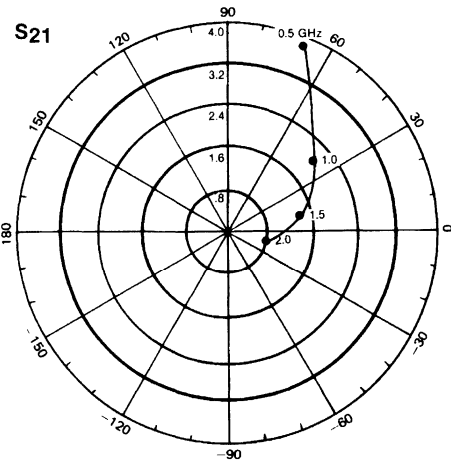
TYPICAL LINEAR GAIN vs COLLECTOR CURRENT



TYPICAL S-PARAMETERS

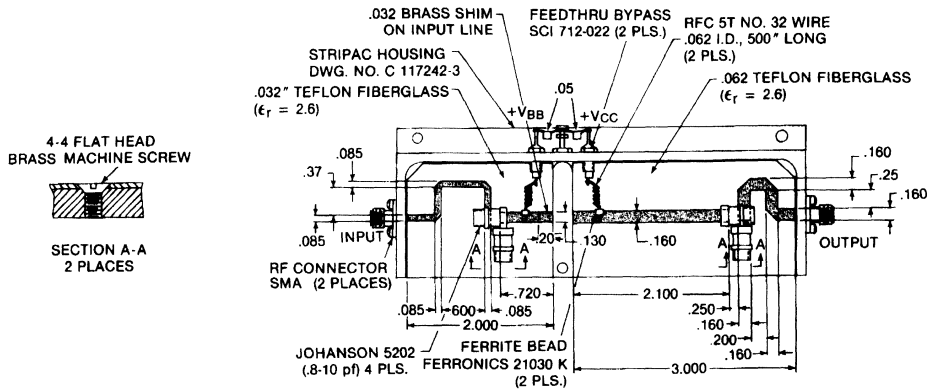


V<sub>CE</sub> = 18 V  
I<sub>C</sub> = 100 mA  
Z<sub>g</sub> = 50 ohms



**TEST CIRCUIT**

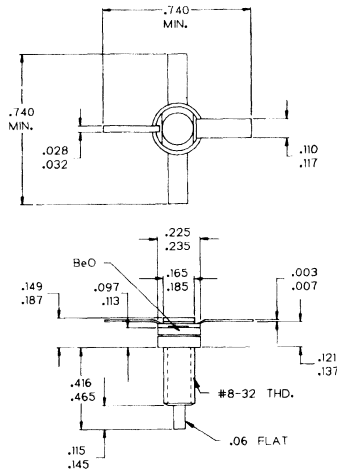
Ref.: Dwg. No. C127323



All dimensions are in inches.  
Frequency 1.0 GHz

**PACKAGE MECHANICAL DATA**

Ref.: Dwg. No.: J135023F



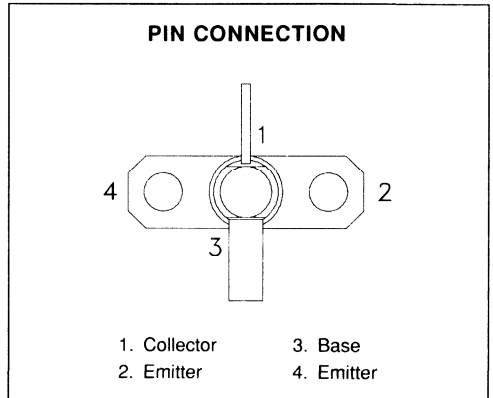
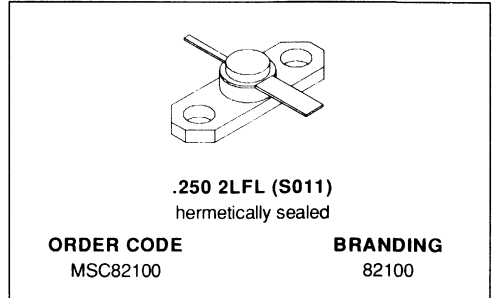
NOTES:  
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.





## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- $f_t$  1.6 GHz TYPICAL
- NOISE FIGURE 15.5 dB @ 2 GHz
- $P_{OUT} = 27$  dBm MIN. @ 1.0 GHz



### DESCRIPTION

The MSC82100 is a hermetically sealed NPN power transistor with a fishbone, emitter finger ballasted geometry utilizing a refractory/gold metallization system. The device is designed specifically for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation (see Safe Area)	—	W
$I_C$	Device Bias Current	200	mA
$V_{CE}$	Collector-Emitter Bias Voltage*	20	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	20	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$	45	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 5\text{mA}$	$I_{\text{B}} = 0\text{mA}$	20	—	—	V
$I_{\text{CEO}}$	$V_{\text{CE}} = 18\text{V}$		—	—	0.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$	15	—	120	—

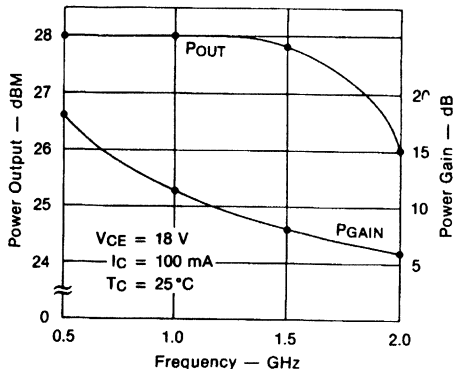
## DYNAMIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$G_{\text{P}}^*$	$f = 1.0\text{ GHz}$	$P_{\text{OUT}} = 27\text{ dBm}$	10.5	11.5	—	dB
$\Delta G_{\text{P}}^*$	$f = 1.0\text{ GHz}$	$P_{\text{OUT}} = 27\text{ dBm}$	—	—	1	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$	—	—	3.2	pF

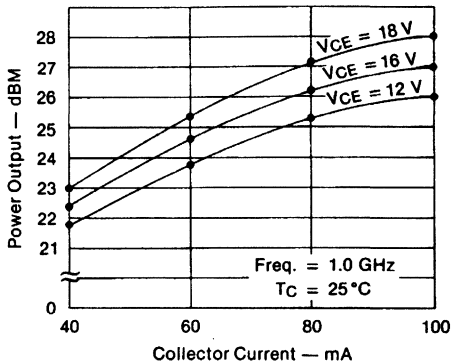
\* Note:  $V_{\text{CE}} = 18\text{V}$   
 $I_{\text{C}} = 100\text{mA}$

TYPICAL PERFORMANCE

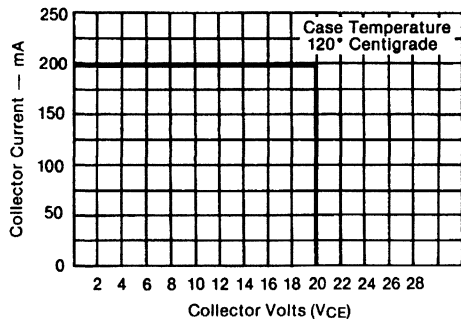
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs FREQUENCY



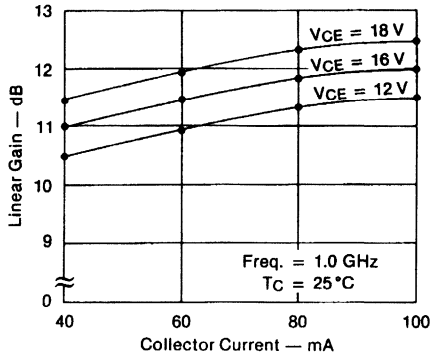
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION

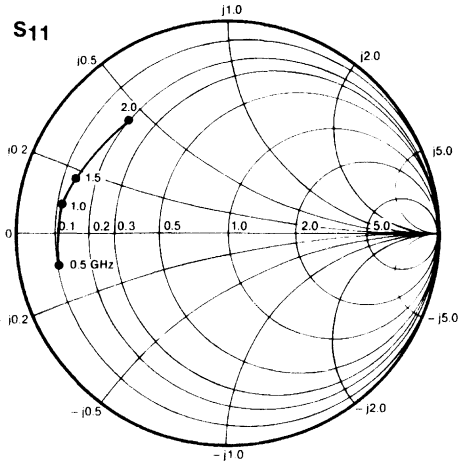


TYPICAL LINEAR GAIN vs COLLECTOR CURRENT

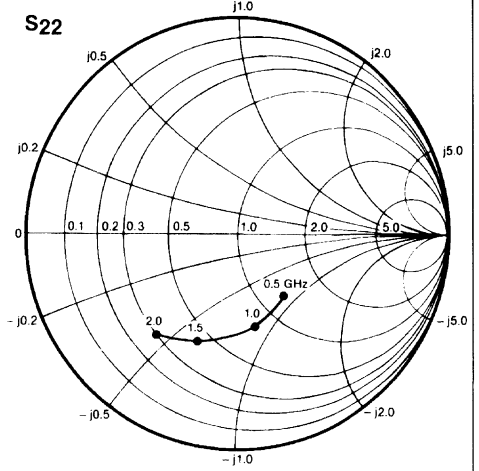


TYPICAL S-PARAMETERS

S11

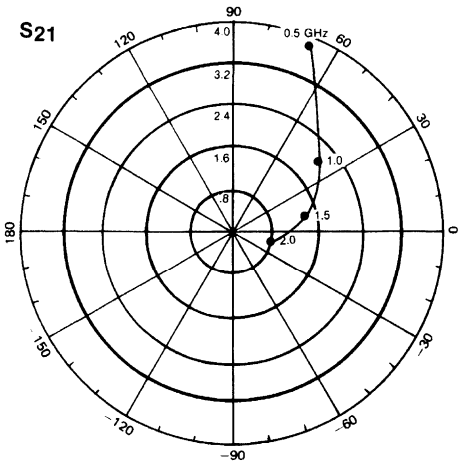


S22

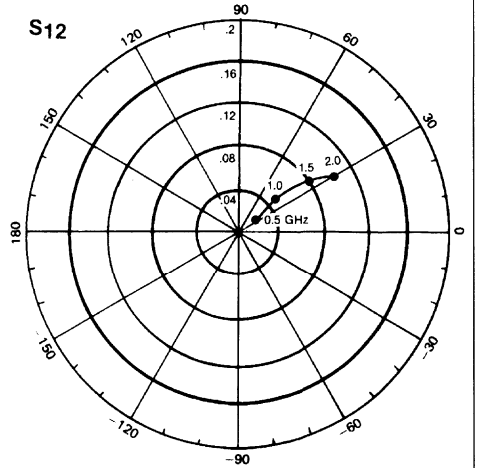


VCE = 18 V  
IC = 100 mA  
Zg = 50 ohms

S21



S12



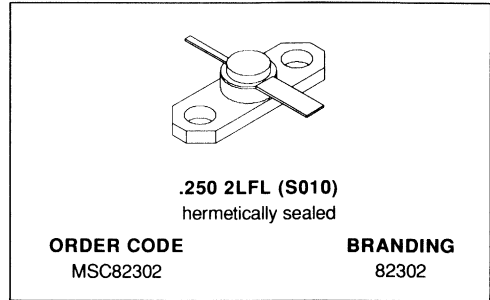




## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

PRELIMINARY DATA

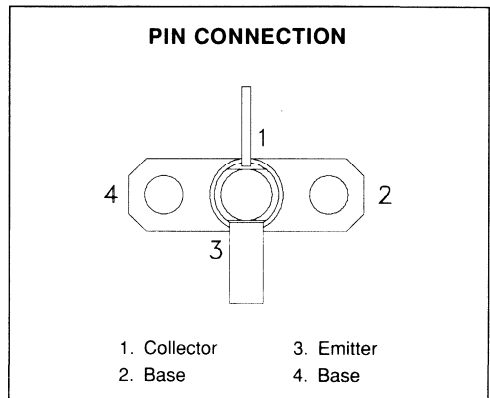
- REFRACTORY/GOLD METALLIZATION
- VSWR CAPABILITY 20:1 @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 1.8$  W MIN. WITH 10.0 dB GAIN



### DESCRIPTION

The MSC82302 is a common base hermetically sealed silicon NPN microwave power transistor utilizing a rugged overlay die geometry. This device is capable of withstanding 20:1 load VSWR at any phase angle under rated conditions.

The MSC82302 was designed for Class C Amplifier/Oscillator applications in the 1.5 - 2.3 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	6.0	W
$I_C$	Device Current*	300	mA
$V_{CC}$	Collector-Supply Voltage*	26	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	25	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$		44	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$		3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$		44	—	—	V
$I_{CBO}$	$V_{CB} = 22V$			—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$		30	—	300	—

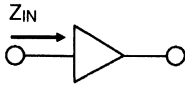
**DYNAMIC**

Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.3 GHz$	$P_{IN} = 0.18 W$	$V_{CC} = 22 V$		1.8	—	—	W
$\eta_C$	$f = 2.3 GHz$	$P_{IN} = 0.18 W$	$V_{CC} = 22 V$		40	—	—	%
$G_P$	$f = 2.3 GHz$	$P_{IN} = 0.18 W$	$V_{CC} = 22 V$		10.0	—	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 22 V$			—	—	3.5	pF

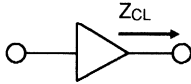


IMPEDANCE DATA

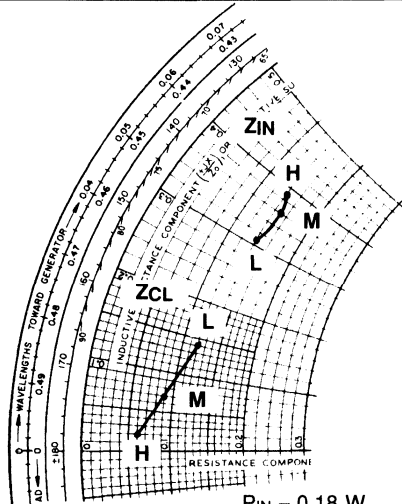
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.0 GHz	7.0 + j 15.5	6.0 + j 7.0
M = 2.15 GHz	7.5 + j 18.0	4.5 + j 3.5
H = 2.3 GHz	7.0 + j 19.5	3.0 + j 1.0

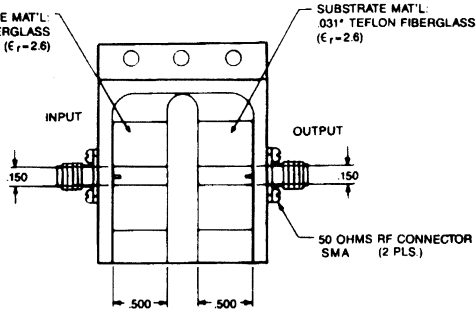


P<sub>IN</sub> = 0.18 W  
 V<sub>CC</sub> = 22 V  
 Normalized to 50 ohms

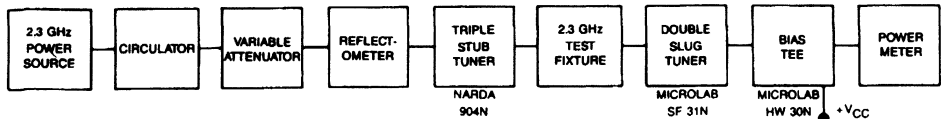
TEST CIRCUIT

Ref: Dwg. No. C125561

All dimensions are in inches  
 Frequency 2.3 GHz

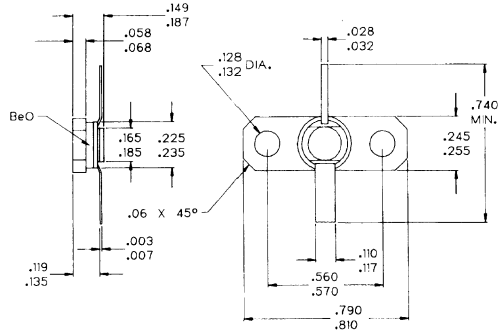


RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C

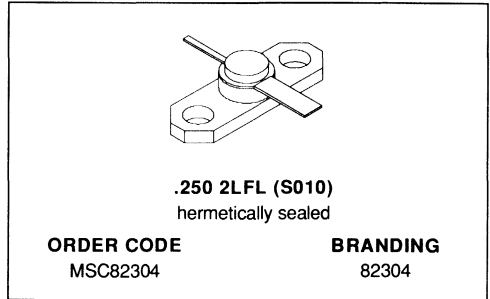


NOTES:  
1. ALL TOLERANCE ± .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

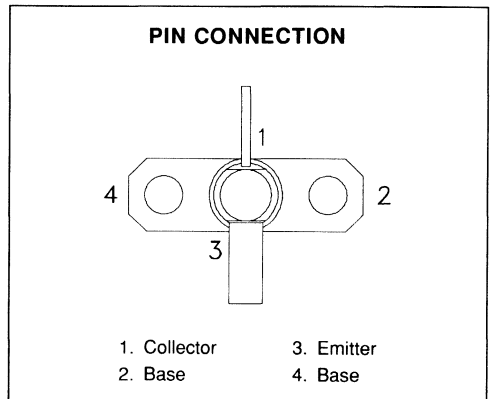
PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- VSWR CAPABILITY 20:1 @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 3.8 \text{ W MIN. WITH } 10.0 \text{ dB GAIN}$


**DESCRIPTION**

The MSC82304 is a common base hermetically sealed silicon NPN microwave power transistor utilizing a rugged overlay die geometry. This device is capable of withstanding 20:1 load VSWR at any phase angle under rated conditions.

The MSC82304 was designed for Class C Amplifier/Oscillator applications in the 1.5 - 2.3 GHz frequency range.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}\text{C}$ )	11.5	W
$I_C$	Device Current*	600	mA
$V_{CC}$	Collector-Supply Voltage*	26	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	13	$^{\circ}\text{C/W}$
---------------	-----------------------------------	----	----------------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

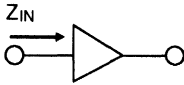
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	44	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	44	—	—	V
$I_{CBO}$	$V_{CB} = 22V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	30	—	300	—

**DYNAMIC**

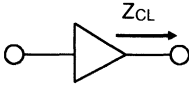
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.3 GHz$	$P_{IN} = 0.38 W$	$V_{CC} = 22 V$	3.8	—	—	W
$\eta_C$	$f = 2.3 GHz$	$P_{IN} = 0.38 W$	$V_{CC} = 22 V$	40	—	—	%
$G_P$	$f = 2.3 GHz$	$P_{IN} = 0.38 W$	$V_{CC} = 22 V$	10.0	—	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 22 V$		—	—	5.0	pF

IMPEDANCE DATA

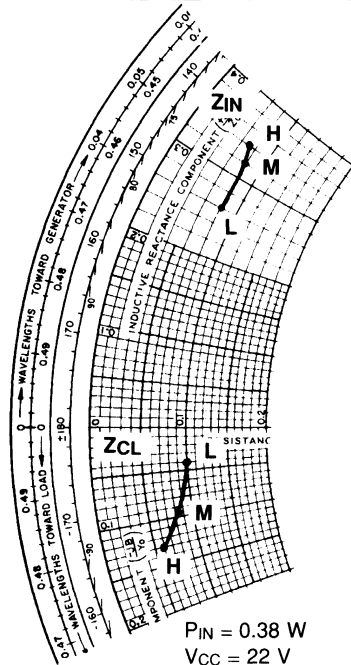
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.0 GHz	3.95 + j 13.0	4.9 - j 1.95
M = 2.15 GHz	3.90 + j 16.0	4.2 - j 4.7
H = 2.3 GHz	3.45 + j 17.0	3.0 - j 6.5

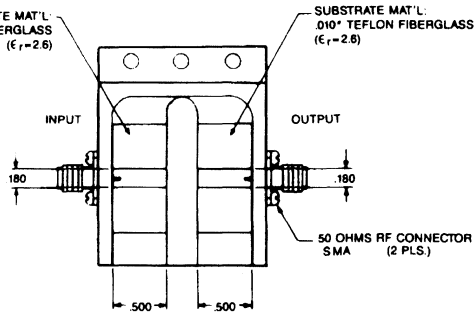


P<sub>IN</sub> = 0.38 W  
 V<sub>CC</sub> = 22 V  
 Normalized to 50 ohms

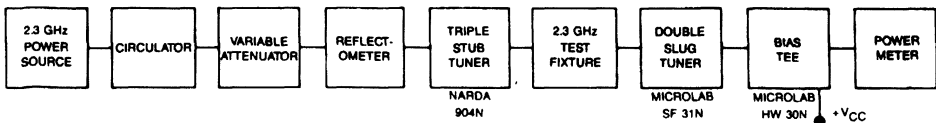
TEST CIRCUIT

Ref.: Dwg. No. C125518

All dimensions are in inches.  
 Frequency 2.3 GHz

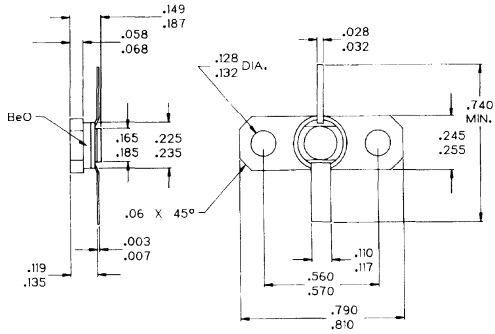


RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C

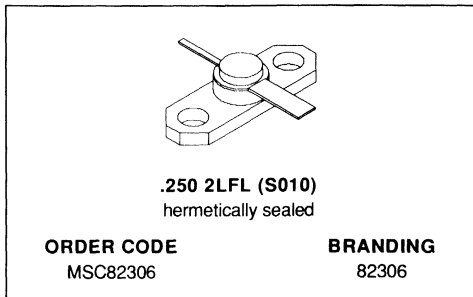


NOTES:  
1. ALL TOLERANCE ± .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

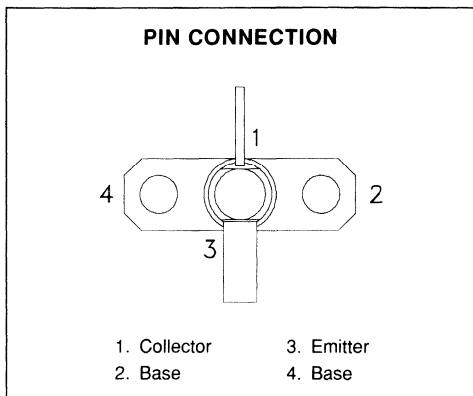
PRELIMINARY DATA

- REFRACTORY\GOLD METALLIZATION
- VSWR CAPABILITY 20:1 @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 5.5 \text{ W MIN. WITH } 9.6 \text{ dB GAIN}$


**DESCRIPTION**

The MSC82306 is a common base hermetically sealed silicon NPN microwave power transistor utilizing a rugged overaly die geometry. This device is capable of withstanding 20:1 load VSWR at any phase angle under rated conditions.

The MSC82306 was designed for Class C Amplifier/Oscillator applications in the 1.5 - 2.3 GHz frequency range.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}\text{C}$ )	16.7	W
$I_C$	Device Current*	900	mA
$V_{CC}$	Collector-Supply Voltage*	26	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	9.0	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$		44	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$		3.5	—	—	V
$BV_{\text{CER}}$	$I_{\text{C}} = 5\text{mA}$	$R_{\text{BE}} = 10\Omega$		44	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 22\text{V}$			—	—	0.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 400\text{mA}$		30	—	300	—

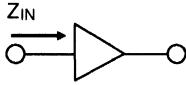
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 2.3\text{ GHz}$	$P_{\text{IN}} = 0.6\text{ W}$	$V_{\text{CC}} = 22\text{ V}$	5.5	6.3	—	W
$\eta_{\text{C}}$	$f = 2.3\text{ GHz}$	$P_{\text{IN}} = 0.6\text{ W}$	$V_{\text{CC}} = 22\text{ V}$	40	45	—	%
$G_{\text{P}}$	$f = 2.3\text{ GHz}$	$P_{\text{IN}} = 0.6\text{ W}$	$V_{\text{CC}} = 22\text{ V}$	9.6	10.2	—	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 22\text{ V}$		—	—	7.0	pF

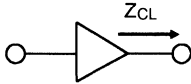


IMPEDANCE DATA

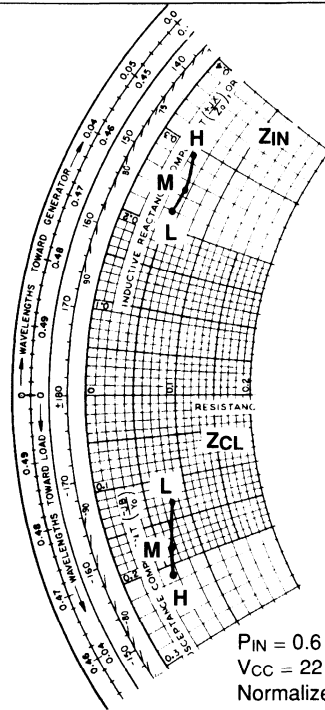
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
L = 2.0 GHz	2.60 + j 11.0	4.1 - j 6.5
M = 2.15 GHz	2.75 + j 12.5	3.3 - j 9.0
H = 2.3 GHz	2.30 + j 14.5	2.8 - j 10.5

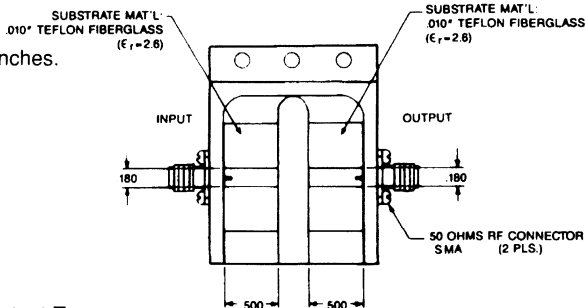


P<sub>IN</sub> = 0.6 W  
 V<sub>CC</sub> = 22 V  
 Normalized to 50 ohms

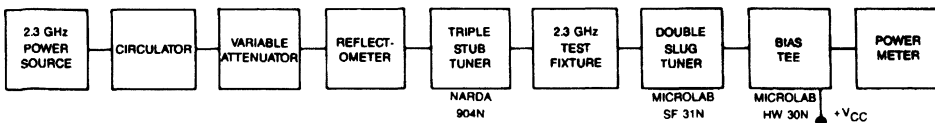
TEST CIRCUIT

Ref.: Dwg. No. C125518

All dimensions are in inches.  
 Frequency 2.3 GHz

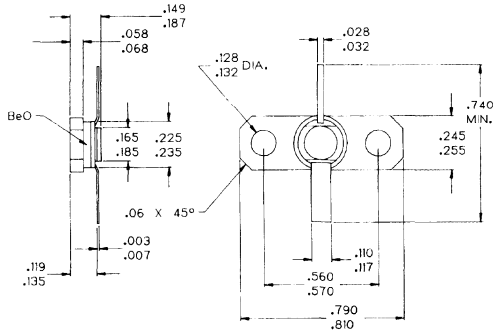


RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C

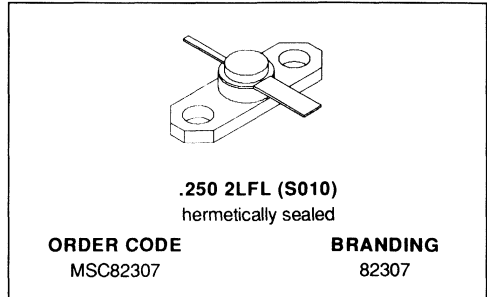


NOTES:  
1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

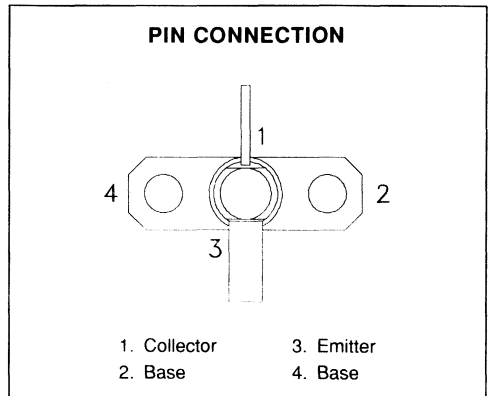
PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- VSWR CAPABILITY 20:1 @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 7.0 \text{ W MIN. WITH } 9.6 \text{ dB GAIN}$


**DESCRIPTION**

The MSC82307 is a common base hermetically sealed silicon NPN microwave power transistor utilizing a rugged overlay die geometry. This device is capable of withstanding 20:1 load VSWR at any phase angle under rated conditions.

The MSC82307 was designed for Class C amplifier/oscillator applications in the 1.5 - 2.3 GHz frequency range.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}\text{C}$ )	21.4	W
$I_C$	Device Current*	1.2	A
$V_{CC}$	Collector-Supply Voltage*	26	V
$T_J$	Junction Temperature	200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	7.0	$^{\circ}\text{C/W}$
---------------	-----------------------------------	-----	----------------------

\*Applies only to rated RF amplifier operation

# MSC82307

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	44	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	44	—	—	V
$I_{CBO}$	$V_{CB} = 22V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	30	—	300	—

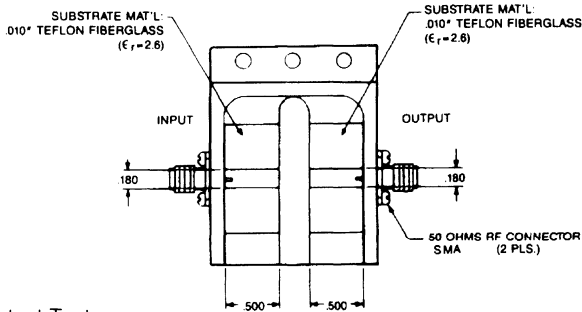
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 2.3 GHz$	$P_{IN} = 0.76 W$	$V_{CC} = 22 V$	7.0	8.0	—	W
$\eta_C$	$f = 2.3 GHz$	$P_{IN} = 0.76 W$	$V_{CC} = 22 V$	40	45	—	%
$G_P$	$f = 2.3 GHz$	$P_{IN} = 0.76 W$	$V_{CC} = 22 V$	9.6	10.2	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 22 V$		—	—	8.5	pF

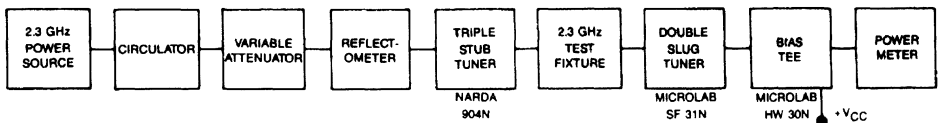
### TEST CIRCUIT

Ref.: Dwg. No. C125518

All dimensions are in inches.  
Frequency 2.3 GHz

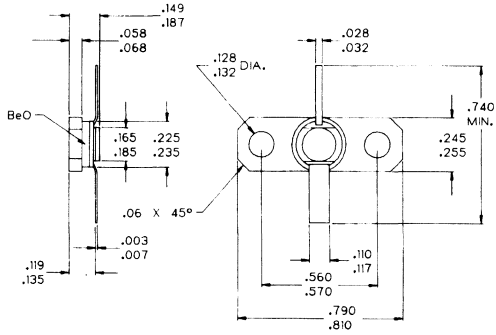


#### RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135021C



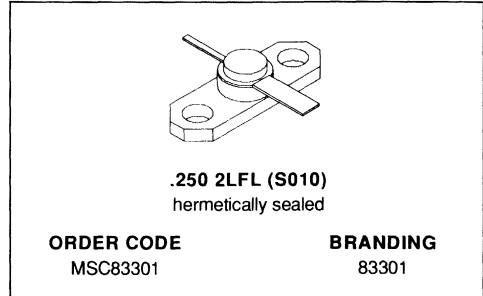
NOTES:

1. ALL TOLERANCE  $\pm$  .010 EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.



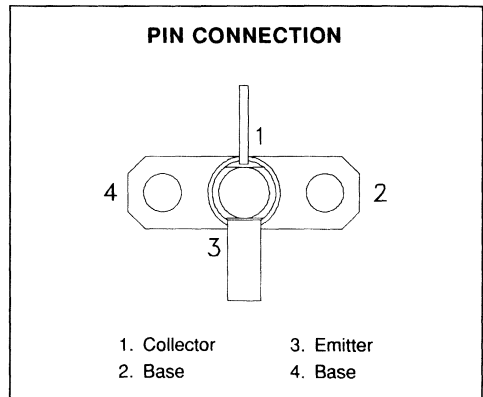
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC® PACKAGE
- $P_{OUT} = 1.0$  W MIN. WITH 7.0 dB GAIN @ 3.0 GHz



### DESCRIPTION

The MSC83301 is a common base hermetically sealed silicon NPN microwave power transistor utilizing an overlay, emitter site ballasted geometry with a refractory gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC83301 is designed for Class C amplifier/oscillator applications in the 1.0 - 3.0 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	6.0	W
$I_C$	Device Current*	200	mA
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	25	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

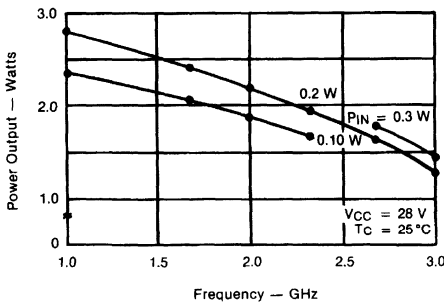
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 1mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 5mA	R <sub>BE</sub> = 10Ω	45	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	0.5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 100mA	30	—	300	—

DYNAMIC

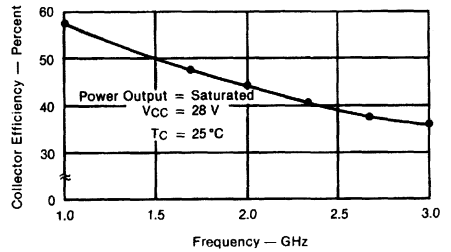
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 3.0 GHz	P <sub>IN</sub> = 0.20 W	V <sub>CC</sub> = 28 V	1.0	1.3	—	W
η <sub>c</sub>	f = 3.0 GHz	P <sub>IN</sub> = 0.20 W	V <sub>CC</sub> = 28 V	33	36	—	%
G <sub>P</sub>	f = 3.0 GHz	P <sub>IN</sub> = 0.20 W	V <sub>CC</sub> = 28 V	7.0	8.1	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	3.5	pF

TYPICAL PERFORMANCE

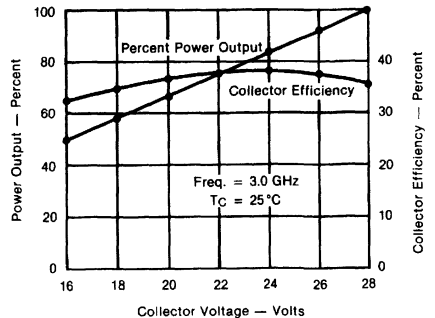
TYPICAL POWER OUTPUT vs FREQUENCY



TYPICAL COLLECTOR EFFICIENCY vs FREQUENCY



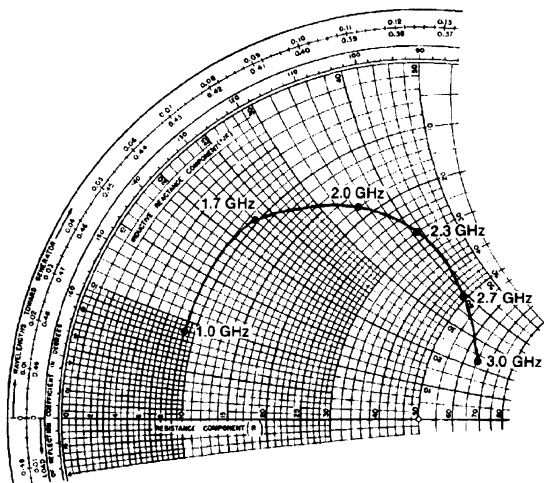
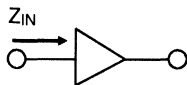
PERCENT POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE





IMPEDANCE DATA

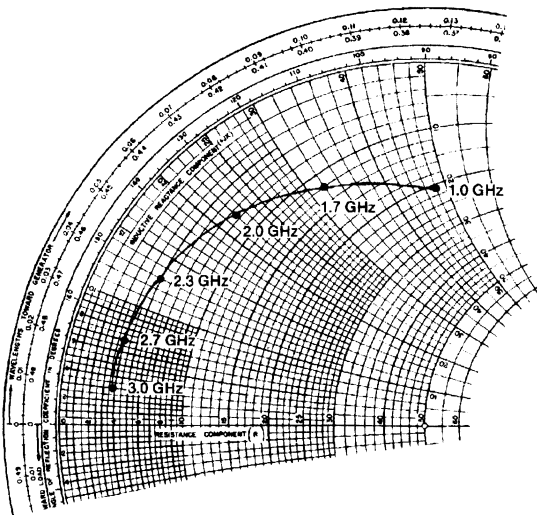
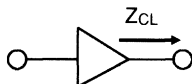
TYPICAL INPUT IMPEDANCE



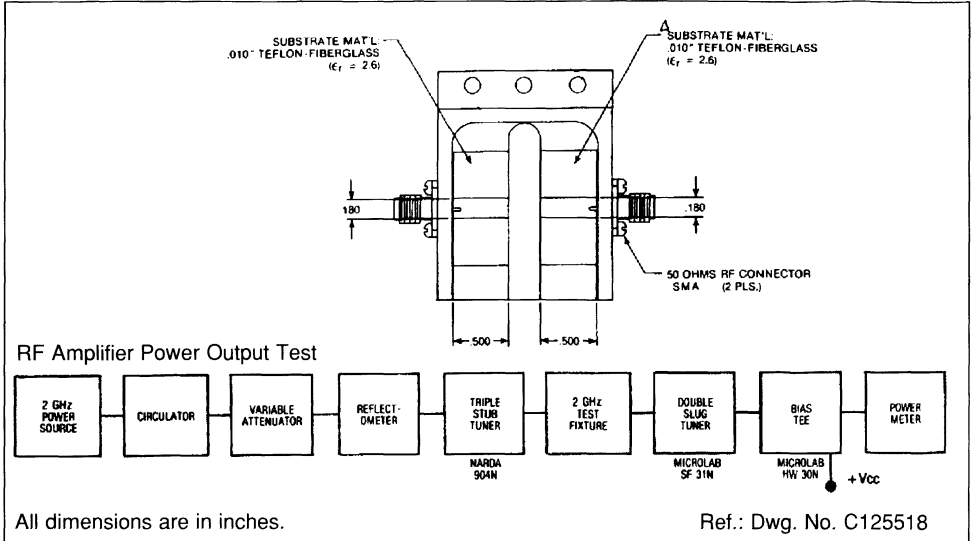
FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1.0 GHz	9.0 + j 9.0	21.0 + j 48.0
1.7 GHz	9.5 + j 23.0	12.0 + j 32.0
2.0 GHz	18.0 + j 34.5	7.5 + j 22.0
2.3 GHz	28.0 + j 41.0	5.0 + j 13.0
2.7 GHz	49.0 + j 39.0	4.0 + j 7.0
3.0 GHz	65.0 + j 22.0	3.8 + j 3.0

P<sub>OUT</sub> = Saturated  
 V<sub>CC</sub> = 28 V  
 Normalized to 50 ohms

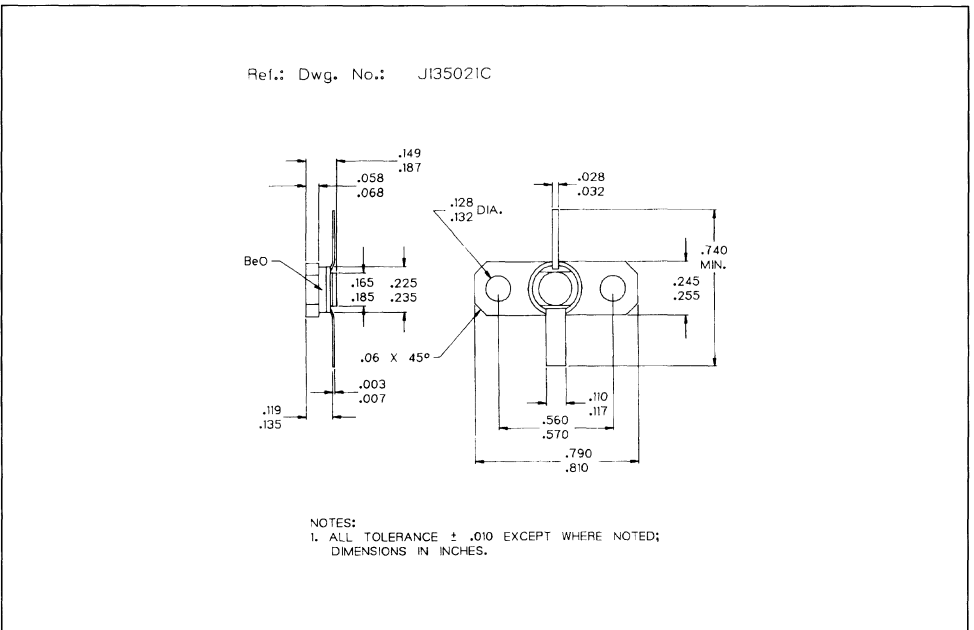
TYPICAL COLLECTOR LOAD IMPEDANCE



TEST CIRCUIT

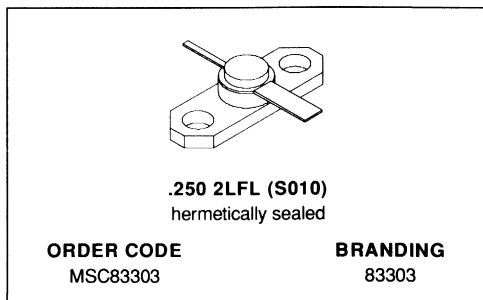


PACKAGE MECHANICAL DATA



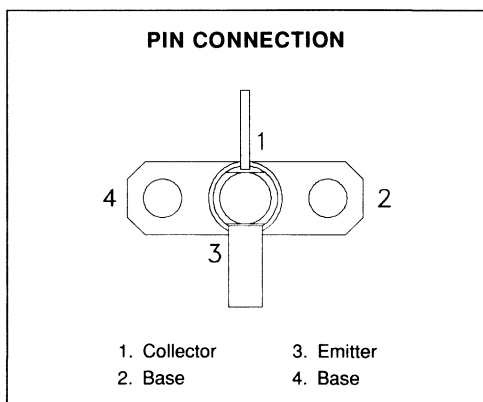
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC<sup>®</sup> PACKAGE
- $P_{OUT} = 1.0$  W MIN. WITH 7.0 dB GAIN @ 3.0 GHz



### DESCRIPTION

The MSC83303 is a common base hermetically sealed silicon NPN microwave power transistor utilizing an overlay, emitter site ballasted geometry with a refractory/gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC83303 is designed for Class C amplifier/oscillator applications in the 1.0 - 3.0 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_C \leq 50^{\circ}C$ )	6.0	W
$I_C$	Device Current*	200	mA
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	25	$^{\circ}C/W$
---------------	-----------------------------------	----	---------------

\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

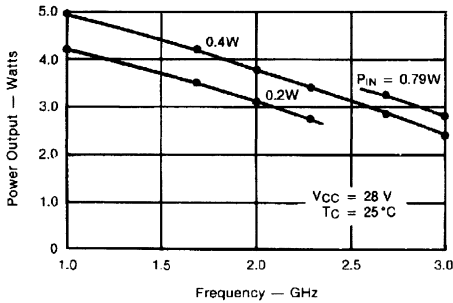
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	45	—	—	V
$I_{CBO}$	$V_{CB} = 28V$		—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 200mA$	30	—	300	—

**DYNAMIC**

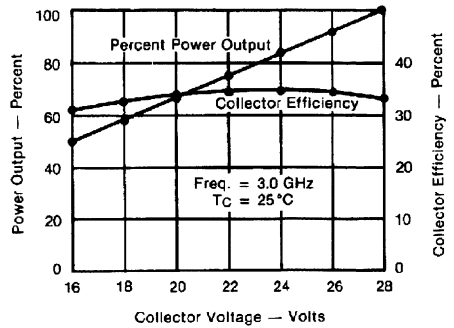
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 3.0\text{ GHz}$	$P_{IN} = 0.79\text{ W}$	$V_{CC} = 28\text{ V}$	2.5	2.8	—	W
$\eta_C$	$f = 3.0\text{ GHz}$	$P_{IN} = 0.79\text{ W}$	$V_{CC} = 28\text{ V}$	30	33	—	%
GP	$f = 3.0\text{ GHz}$	$P_{IN} = 0.79\text{ W}$	$V_{CC} = 28\text{ V}$	5.0	5.5	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	5	pF

**TYPICAL PERFORMANCE**

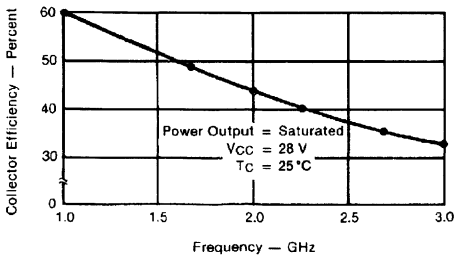
**TYPICAL POWER OUTPUT vs FREQUENCY**



**PERCENT POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE**

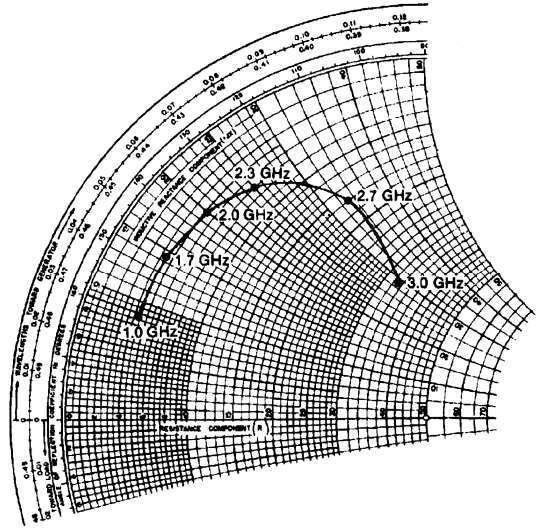
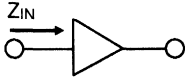


**TYPICAL COLLECTOR EFFICIENCY vs FREQUENCY**



IMPEDANCE DATA

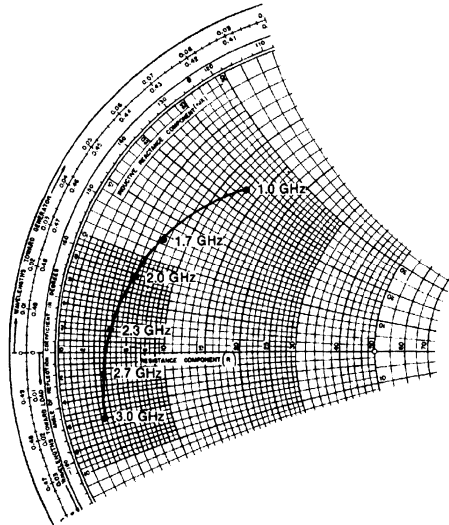
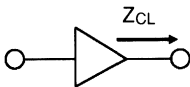
TYPICAL INPUT IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1.0 GHz	4.4 + j 8.7	13.0 + j 23.0
1.7 GHz	4.5 + j 14.5	7.5 + j 12.5
2.0 GHz	5.1 + j 20.0	6.0 + j 7.8
2.3 GHz	7.0 + j 25.0	4.5 + j 2.2
2.7 GHz	16.0 + j 33.0	3.8 - j 2.0
3.0 GHz	33.0 + j 29.0	3.3 - j 6.0

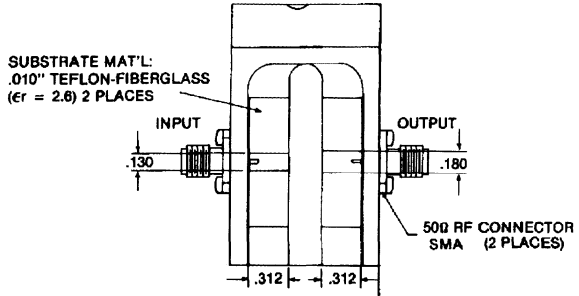
P<sub>OUT</sub> = Saturated  
 V<sub>CC</sub> = 28 V  
 Normalized to 50 ohms

TYPICAL COLLECTOR LOAD IMPEDANCE

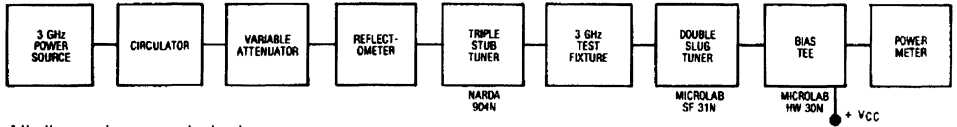


TEST CIRCUIT

Ref.: Dwg. No. C125562



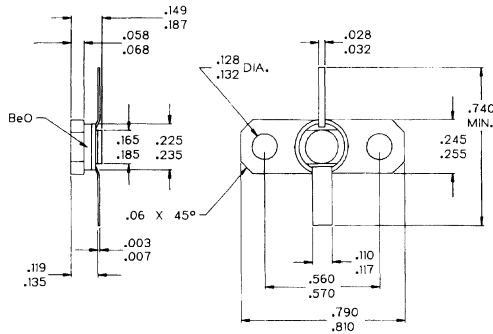
RF Amplifier Power Output Test



All dimensions are in inches.  
Frequency 3.0 GHz

PACKAGE MECHANICAL DATA

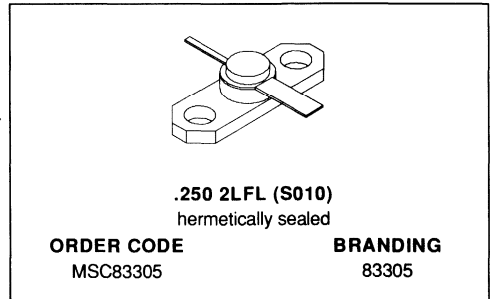
Ref.: Dwg. No.: J135021C



NOTES:  
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

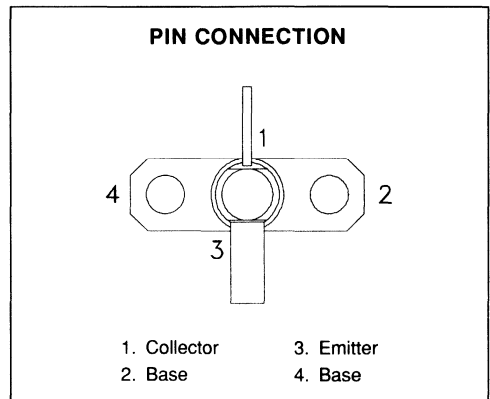
## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE AMPLIFIER APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER BALLASTED
- VSWR CAPABILITY  $\infty:1$  @ RATED CONDITIONS
- HERMETIC STRIPAC<sup>®</sup> PACKAGE
- $P_{OUT} = 4.5$  W MIN. WITH 4.5 dB GAIN @ 3.0 GHz



### DESCRIPTION

The MSC83305 is a common base hermetically sealed silicon NPN microwave power transistor utilizing an emitter site ballasted geometry with a refractory gold metallization system. This device is capable of withstanding an infinite load VSWR at any phase angle under rated conditions. The MSC83305 was designed for Class C amplifier/oscillator applications in the 1.0 - 3.0 GHz frequency range.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$P_{DISS}$	Power Dissipation* ( $T_c \leq 50^{\circ}C$ )	17.6	W
$I_c$	Device Current*	700	mA
$V_{CC}$	Collector-Supply Voltage*	30	V
$T_J$	Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	8.5	$^{\circ}C/W$
---------------	-----------------------------------	-----	---------------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

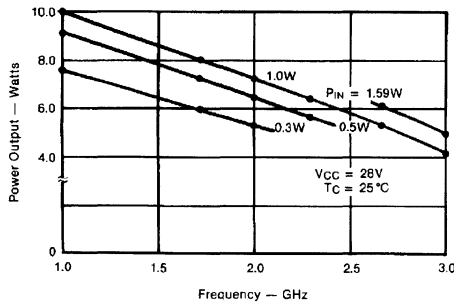
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 1mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 5mA	R <sub>BE</sub> = 10Ω	45	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V		—	—	0.5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500mA	30	—	300	—

DYNAMIC

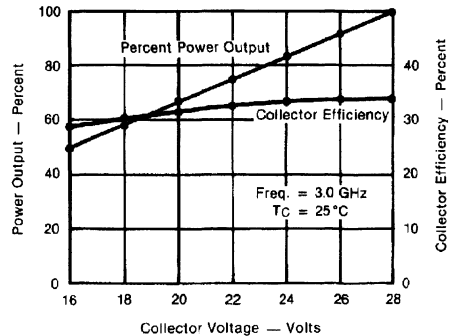
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 3.0 GHz	P <sub>IN</sub> = 1.59 W	V <sub>CC</sub> = 28 V	4.5	5.0	—	W
η <sub>c</sub>	f = 3.0 GHz	P <sub>IN</sub> = 1.59 W	V <sub>CC</sub> = 28 V	30	33	—	%
G <sub>p</sub>	f = 3.0 GHz	P <sub>IN</sub> = 1.59 W	V <sub>CC</sub> = 28 V	4.5	5.0	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	7.5	pF

TYPICAL PERFORMANCE

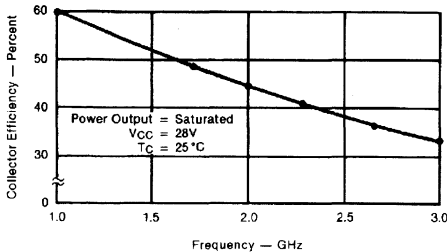
POWER OUTPUT vs FREQUENCY



PERCENT POWER OUTPUT & COLLECTOR EFFICIENCY vs COLLECTOR VOLTAGE



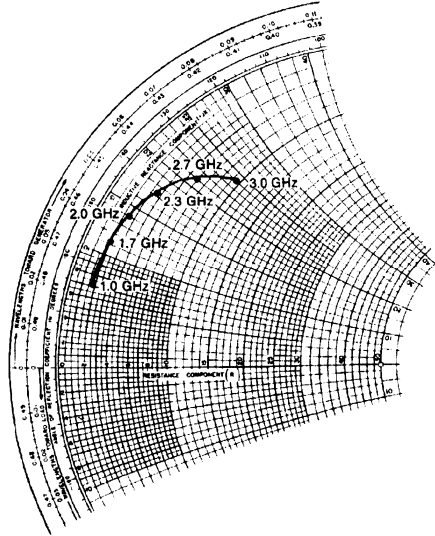
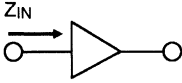
COLLECTOR EFFICIENCY vs FREQUENCY





IMPEDANCE DATA

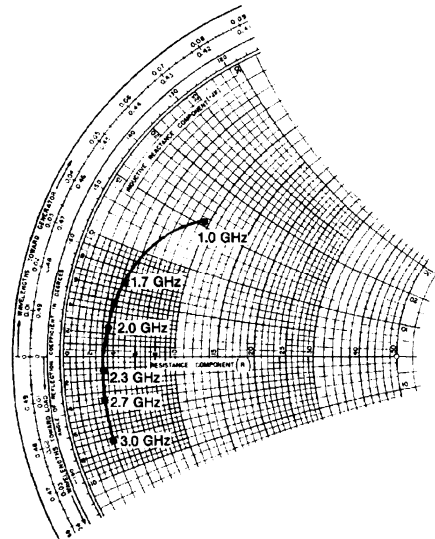
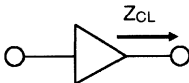
TYPICAL INPUT IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1.0 GHz	1.7 + j 7.2	9.5 + j 15.5
1.7 GHz	2.0 + j 11.2	4.2 + j 6.7
2.0 GHz	2.4 + j 14.0	3.5 + j 2.5
2.3 GHz	3.6 + j 17.4	3.1 - j 1.2
2.7 GHz	6.0 + j 21.0	3.0 - j 3.8
3.0 GHz	9.5 + j 24.0	3.0 - j 7.2

P<sub>OUT</sub> = Saturated  
 V<sub>CC</sub> = 28V  
 Normalized to 50 ohms

TYPICAL COLLECTOR LOAD IMPEDANCE

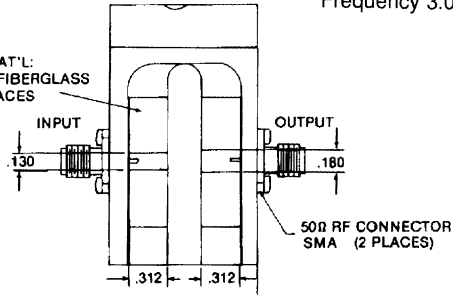


TEST CIRCUIT

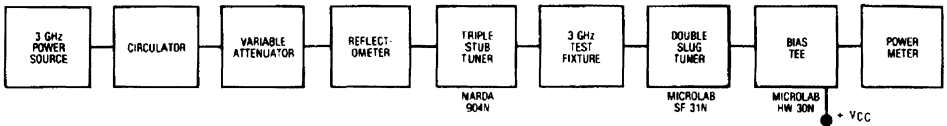
Ref.: Dwg. No. C125562

All dimensions are in inches.  
Frequency 3.0 GHz

SUBSTRATE MAT'L:  
.010" TEFLON-FIBERGLASS  
( $\epsilon_r = 2.6$ ) 2 PLACES

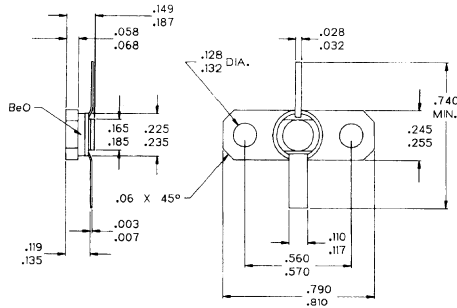


RF Amplifier Power Output Test



PACKAGE MECHANICAL DATA

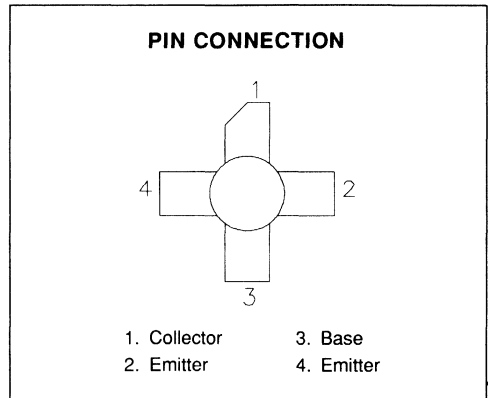
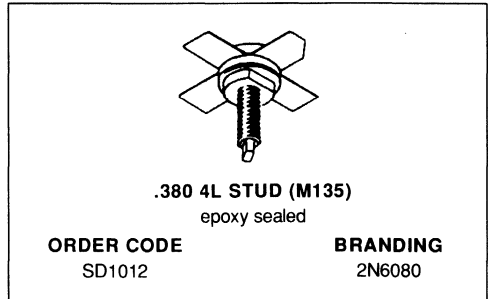
Ref.: Dwg. No.: J135021C



NOTES:  
1. ALL TOLERANCE  $\pm .010$  EXCEPT WHERE NOTED;  
DIMENSIONS IN INCHES.

**RF & MICROWAVE TRANSISTORS  
 VHF FM MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- HIGH EFFICIENCY
- COMMON EMITTER
- FM CLASS C TRANSISTOR
- $P_{OUT} = 4 \text{ W MIN. WITH } 12 \text{ dB GAIN}$


**DESCRIPTION**

The SD1012 is an epitaxial silicon NPN planar transistor designed primarily for VHF mobile and marine transmitters. The device utilizes emitter ballasting resistors and improved metallization systems to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	1.0	A
$P_{DISS}$	Power Dissipation	12	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	15	$^{\circ}\text{C/W}$
---------------	----------------------------------	----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

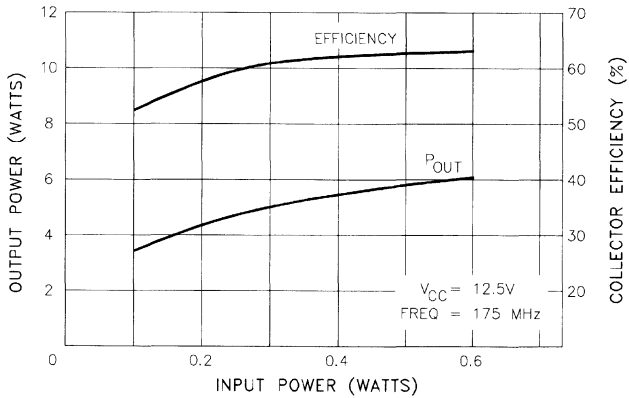
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 5mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 10mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	.25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 0.25A$	5	—	200	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175 MHz$	$P_{IN} = 0.25 W$	$V_{CE} = 12.5 V$	4	—	—	W
$G_P$	$f = 175 MHz$	$P_{IN} = 0.25 W$	$V_{CE} = 12.5 V$	12	—	—	dB
$\eta_C$	$f = 175 MHz$	$P_{IN} = 0.25 W$	$V_{CE} = 12.5 V$	50	—	—	%
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 15 V$		—	—	20	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**



## IMPEDANCE DATA

$P_{IN}$ (W)	$P_{OUT}$ (W)	$Z_{IN}$ ( $\Omega$ )	$Z_{OUT}$ ( $\Omega$ )
0.1	3.3	$1.5 + j 1.7$	$5.8 + j 1.4$
0.3	4.9	$2.2 + j 1.3$	$7.6 + j 9.8$
0.5	5.8	$2.9 + j 0.4$	$8.4 + j 6.9$

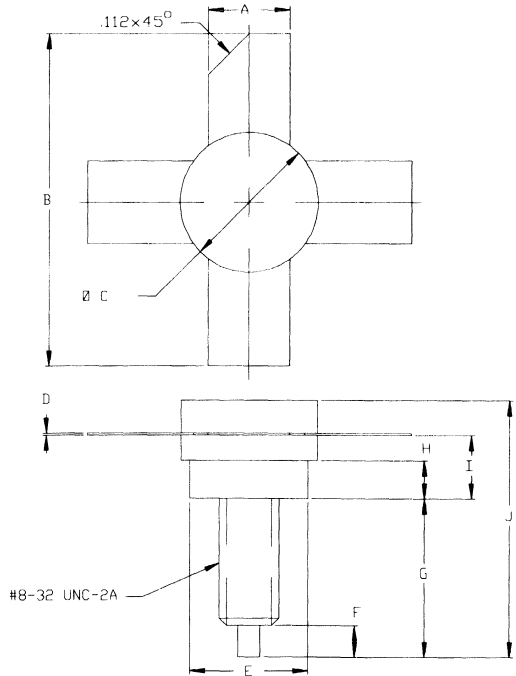
Freq. = 175 MHz

$V_{CC}$  = 12.5 V

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0135

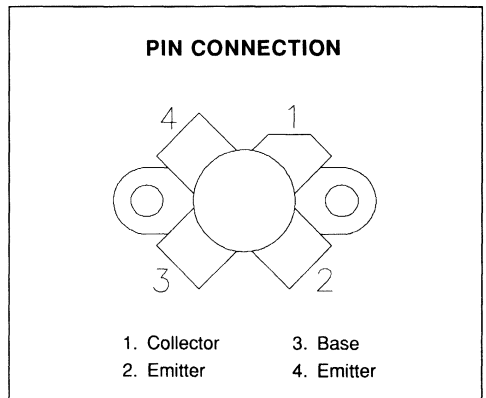
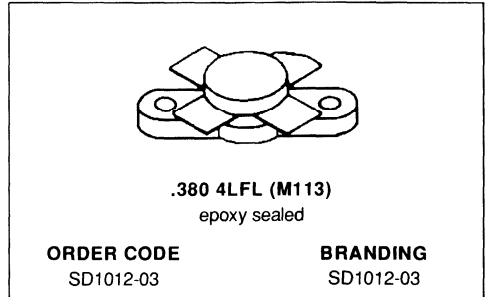
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05





**RF & MICROWAVE TRANSISTORS  
 VHF MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- EFFICIENCY 50%
- COMMON EMITTER
- $P_{OUT} = 6 \text{ W MIN. WITH } 9 \text{ dB GAIN}$


**DESCRIPTION**

The SD1012-03 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications in the 136 - 175 MHz frequency range. Emitter ballasting is employed to achieve excellent ruggedness under severe load mismatch conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36.0	V
$V_{CEO}$	Collector-Emitter Voltage	18.0	V
$V_{CES}$	Collector-Emitter Voltage	36.0	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	1.8	A
$P_{DISS}$	Power Dissipation (+25°C)	20.0	W
$T_J$	Junction Temperature	+200	°C
$T_{STG}$	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	8.75	°C/W
---------------	----------------------------------	------	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

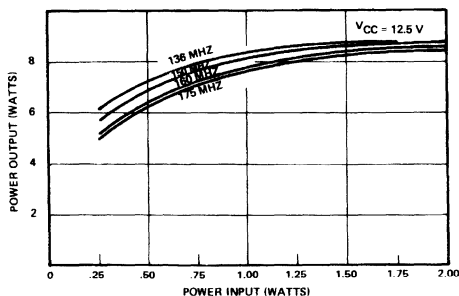
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 5mA$	36.0	—	—	V
$BV_{CEO}$	$I_C = 10mA$	18.0	—	—	V
$BV_{EBO}$	$I_E = 1mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$ $I_C = .25A$	5	—	—	—

DYNAMIC

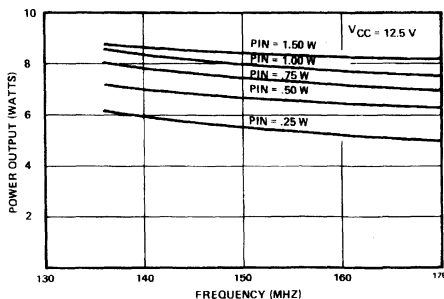
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175 MHz$	$P_{IN} = .75 W$	$V_{CC} = 12.5 V$	6.0	—	—	W
$\eta_C$	$f = 175 MHz$	$P_{IN} = .75 W$	$V_{CC} = 12.5 V$	50	—	—	%
GP	$f = 175 MHz$	$P_{IN} = .75 W$	$V_{CC} = 12.5 V$	9.0	—	—	dB
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 15 V$		—	—	20	pF

TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

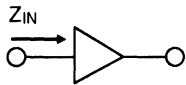
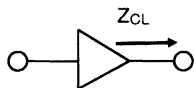


POWER OUTPUT vs FREQUENCY





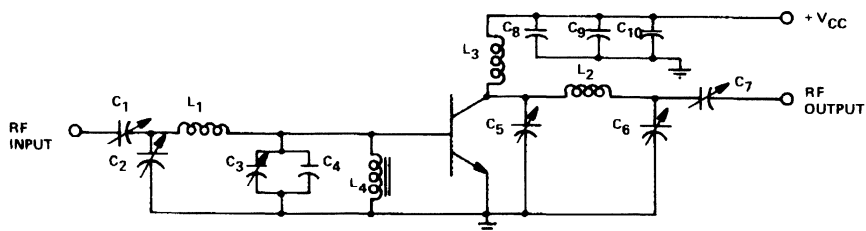
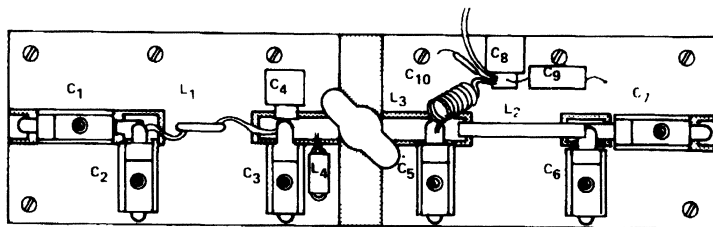
## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
150 MHz	4.90 + j 3.46	11.4 + j 4.56
175 MHz	4.32 + j 3.04	13.0 + j 7.81

V<sub>CC</sub> = 12.5 VP<sub>IN</sub> = 1 WP<sub>OUT</sub> = 8.1 @ 150 MHzP<sub>OUT</sub> = 7.7 @ 175 MHz

## TEST CIRCUIT

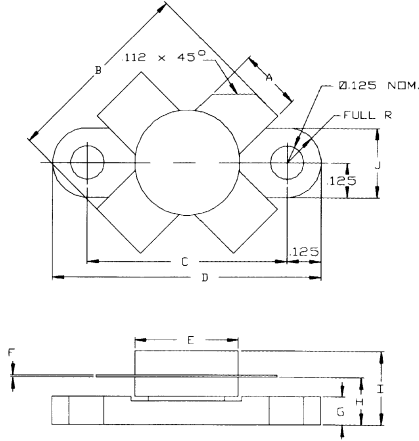


C1,C2,C6 : 4-40pF, ARCO 422  
 C3,C5 : 7-100pF, ARCO 423  
 C4 : 25pF, UNELO  
 C7 : 24-200pF, ARCO 425  
 C8 : 1000pF Unelco  
 C9 : 10μF Electrolytic 35 Vdc  
 C10 : .01μF Disc

L1 : 1 Turn, #18 AWG, 5/16" I.D.  
 L2 : Cu .003", 1 3/4" Long, 3/16" Wide, 5/16" Height  
 L3 : 10 Turns #22 Enameled Tightly Wound on 300Ω 1/2 Watt Carbon Resistor  
 L4 : RFC, 2 1/2 Turns on VK2K/07-3B Ferroxcube

PACKAGE MECHANICAL DATA

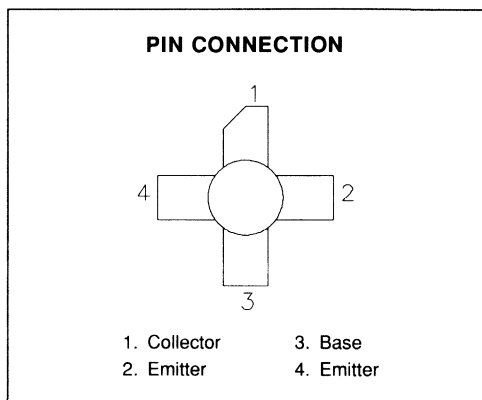
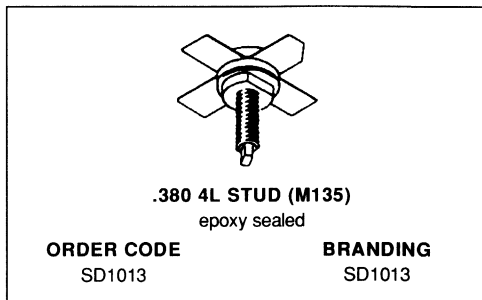
Ref.: Dwg. No.12-0113



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.385/9,78
F	.004/0,10	.006/0,15
G	.085/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48

**RF & MICROWAVE TRANSISTORS  
 VHF APPLICATIONS**

- 150 MHz
- 28 VOLTS
- COMMON EMITTER
- TYPICAL EFFICIENCY 55%
- $P_{OUT} = 10 \text{ W MIN. WITH } 10 \text{ dB GAIN}$


**DESCRIPTION**

The SD1013 is a 28 V Class C epitaxial silicon NPN planar transistor designed for 108 - 152 MHz FM applications.

This device utilizes emitter resistors to achieve infinite VSWR at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65.0	V
$V_{CEO}$	Collector-Emitter Voltage	35.0	V
$V_{CES}$	Collector-Emitter Voltage	65.0	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	1.0	A
$P_{DISS}$	Power Dissipation	13.0	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	13.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 200mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 200mA	V <sub>BE</sub> = 0V	65	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 200mA	I <sub>B</sub> = 0mA	35	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 30V	I <sub>E</sub> = 0mA	—	—	1.0	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 200mA	5.0	—	—	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 150 MHz	P <sub>IN</sub> = 1.0 W	V <sub>CC</sub> = 28 V	10	—	—	W
G <sub>P</sub>	f = 150 MHz	P <sub>IN</sub> = 1.0 W	V <sub>CC</sub> = 28 V	10	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 30V		—	—	15	pF

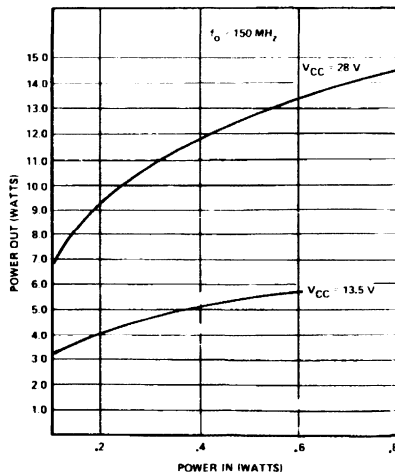
Note: When used at 13.5 Volts performances are:

P<sub>OUT</sub> = 3.5 Watt Typical

G<sub>P</sub> = 10.5 dB Typical

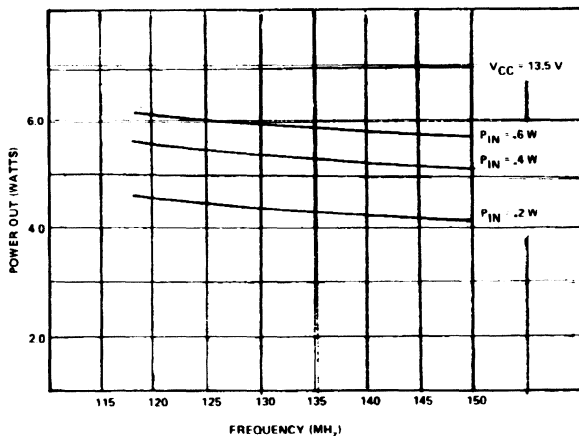
TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

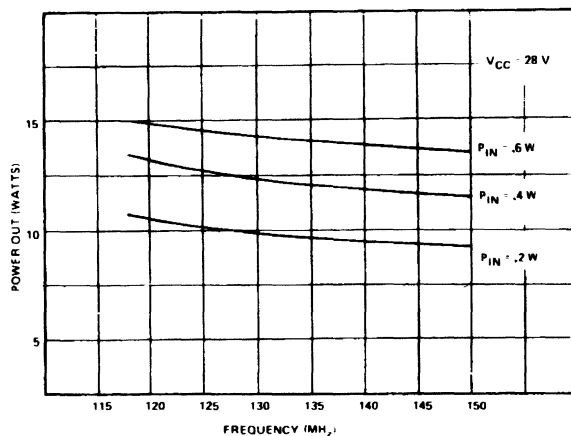


## TYPICAL PERFORMANCE (cont'd)

POWER OUTPUT vs FREQUENCY (13.5 V)

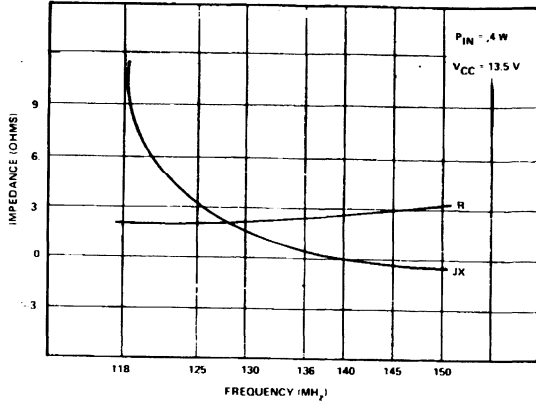
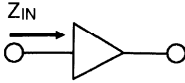


POWER OUTPUT vs FREQUENCY (28 V)

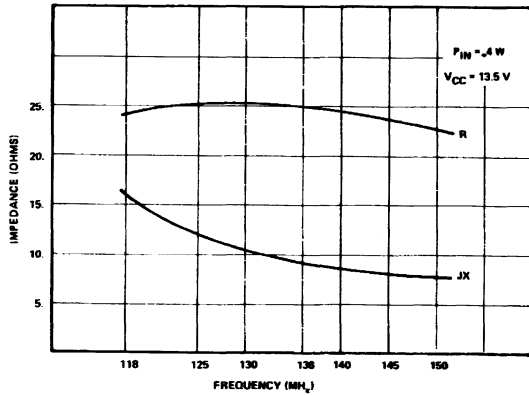
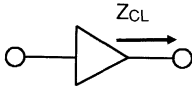


IMPEDANCE DATA (13.5 V)

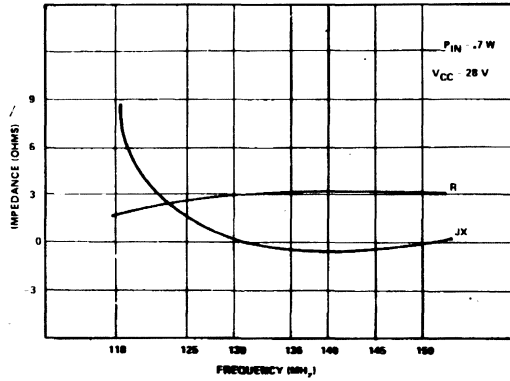
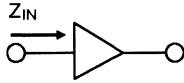
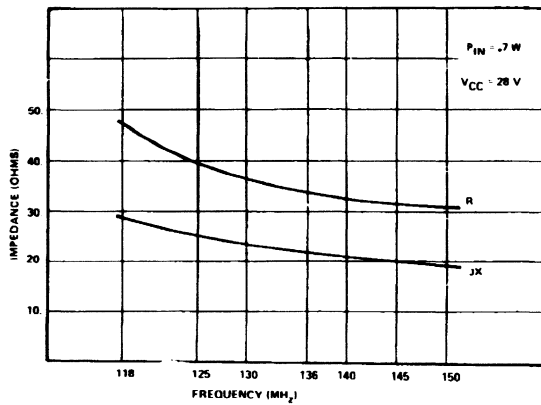
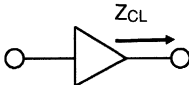
TYPICAL INPUT IMPEDANCE



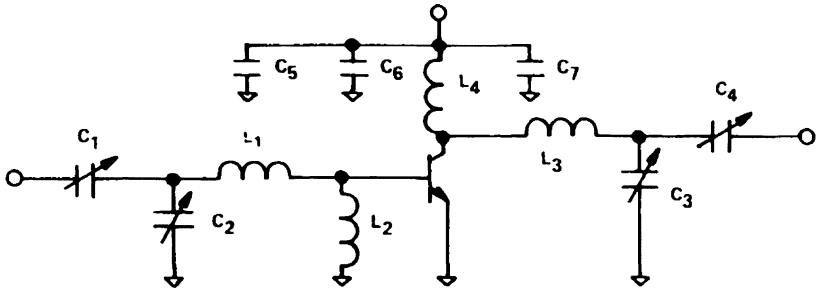
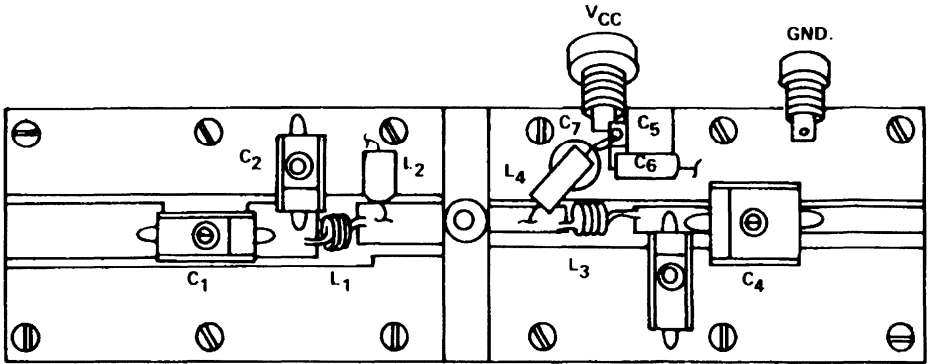
TYPICAL COLLECTOR LOAD IMPEDANCE



## IMPEDANCE DATA (28 V)

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

TEST CIRCUIT



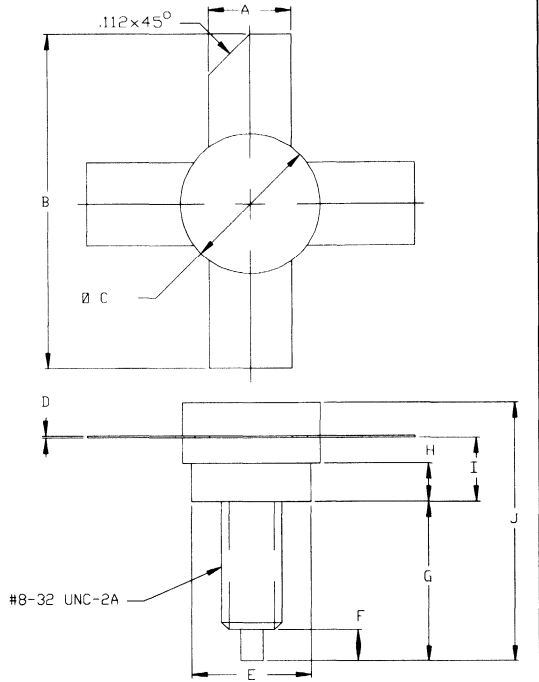
- |                            |                             |
|----------------------------|-----------------------------|
| C1, C2 : ARCO 422          | C7 : .01pF Ceramic Disc     |
| C3 : ARCO 421              | L1 : 3Turns #22, 1/8" I.D.  |
| C4 : ARCO 464              | L2 : RFC Ferroxcube         |
| C5 : 1000pF UNELCO         | L3 : 3 Turns #18, 1/4" I.D. |
| C6 : 10μF Electrolytic 35V | L4 : .47μH Molded Choke     |



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0135

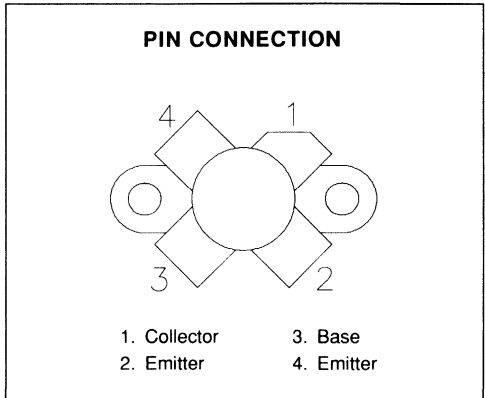
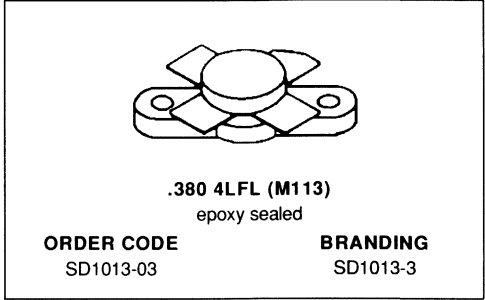
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05





## RF & MICROWAVE TRANSISTORS VHF APPLICATIONS

- 150 MHz
- 28 VOLTS
- COMMON EMITTER
- EFFICIENCY 50% TYPICAL
- $P_{OUT} = 10$  W MIN. WITH 10 dB GAIN



### DESCRIPTION

The SD1013-03 is a 28 V Class C epitaxial silicon NPN planar transistor designed for 108 - 152 MHz FM applications.

This device utilizes diffused emitter resistors to achieve infinite VSWR at rated operating conditions.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	65	V
V <sub>CEO</sub>	Collector-Emitter Voltage	35	V
V <sub>CES</sub>	Collector-Emitter Voltage	65	V
V <sub>EBO</sub>	Emitter-Base Voltage	4	V
I <sub>c</sub>	Device Current	1	A
P <sub>DISS</sub>	Power Dissipation (+25°C)	13	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	13.5	°C/W
----------------------	----------------------------------	------	------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 200\text{mA}$	$I_{\text{E}} = 0\text{mA}$	65	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 200\text{mA}$	$V_{\text{BE}} = 0\text{V}$	65	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 200\text{mA}$	$I_{\text{B}} = 0\text{mA}$	35	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	1	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 200\text{mA}$	5	—	200	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 150\text{ MHz}$	$P_{\text{IN}} = 1.0\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	10	—	—	W
$G_{\text{P}}$	$f = 150\text{ MHz}$	$P_{\text{IN}} = 1.0\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	10	—	—	dB
$\text{COB}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 30\text{ V}$		—	—	1	pF

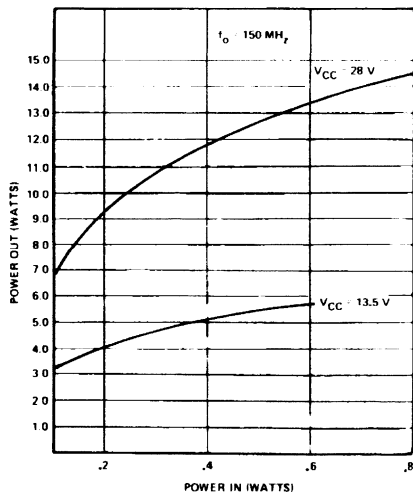
Note: When used at 13.5 Volts performances are:

$P_{\text{OUT}} = 3.5\text{ Watts Typical}$

$G_{\text{P}} = 10.5\text{ dB Typical}$

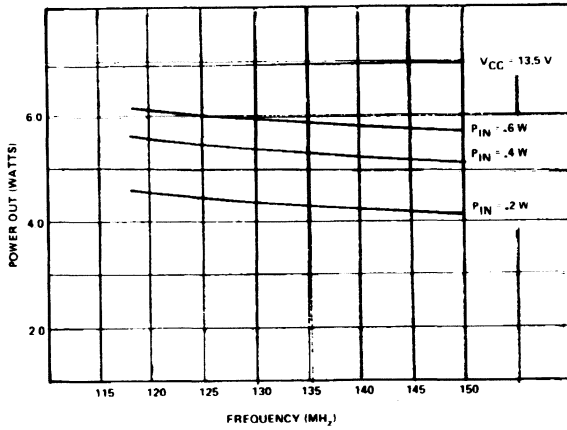
## TYPICAL PERFORMANCE

## POWER OUTPUT vs POWER INPUT

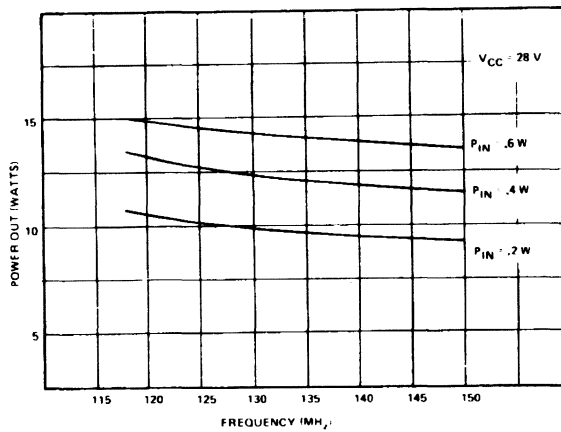


## TYPICAL PERFORMANCE (cont'd)

## POWER OUTPUT vs FREQUENCY (13.5 V)

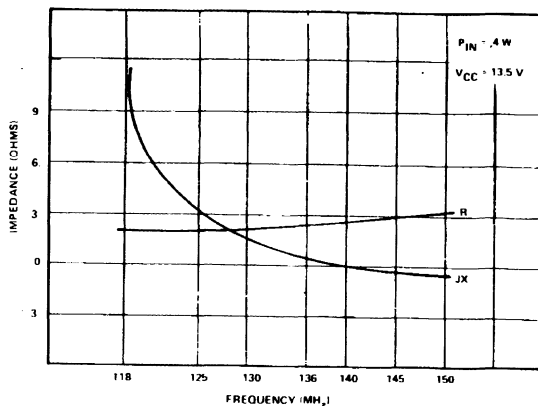
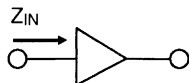


## POWER OUTPUT vs FREQUENCY (28 V)

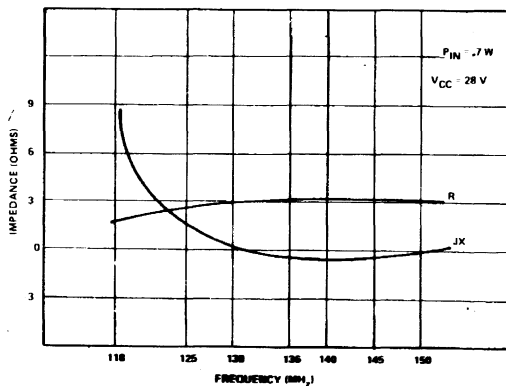
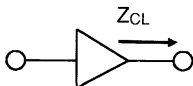


IMPEDANCE DATA (13.5 V)

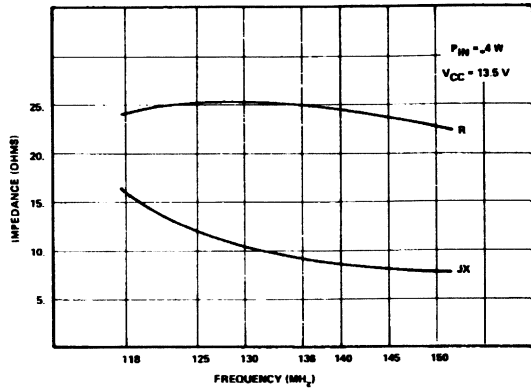
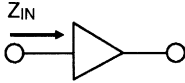
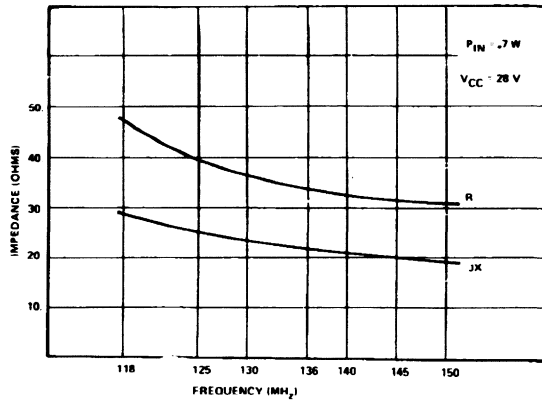
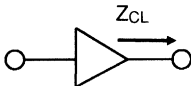
TYPICAL INPUT IMPEDANCE



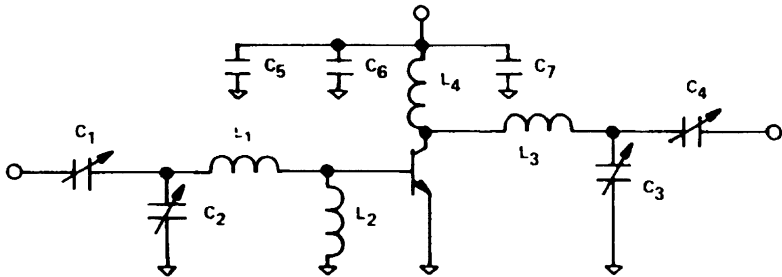
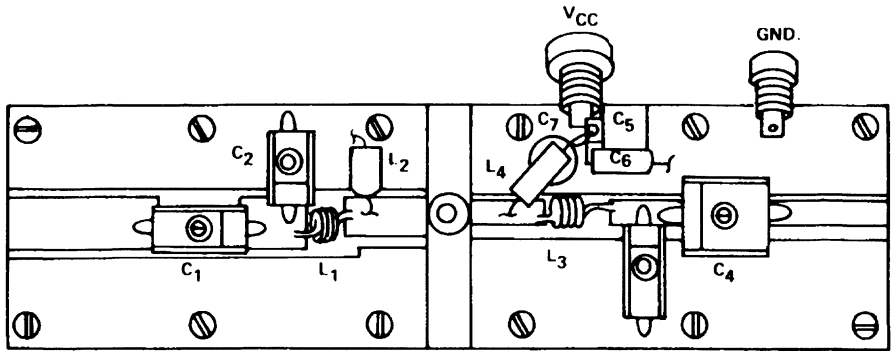
TYPICAL COLLECTOR LOAD IMPEDANCE



## IMPEDANCE DATA (28 V)

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

## TEST CIRCUIT



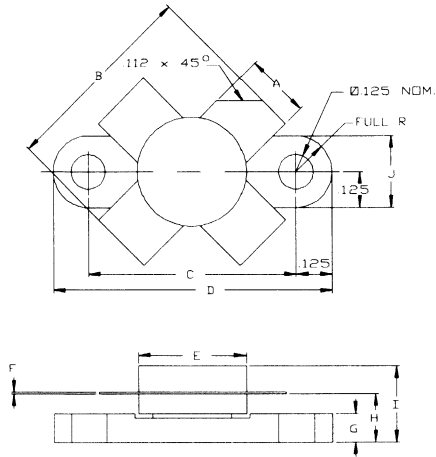
C1, C2 : ARCO 422  
 C3 : ARCO 421  
 C4 : ARCO 464  
 C5 : 1000pF Unelco  
 C6 : 10 $\mu$ F Electrolytic 35V

C7 : .01pF Ceramic Disc  
 L1 : 3Turns #22, 1/8" I.D.  
 L2 : RFC Ferroxcube  
 L3 : 3 Turns #18, 1/4" I.D.  
 L4 : .47 $\mu$ h Molded Choke



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0113

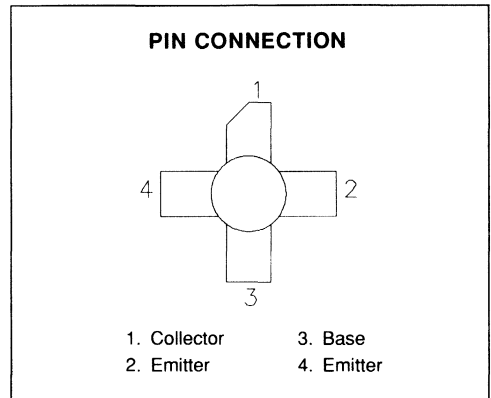
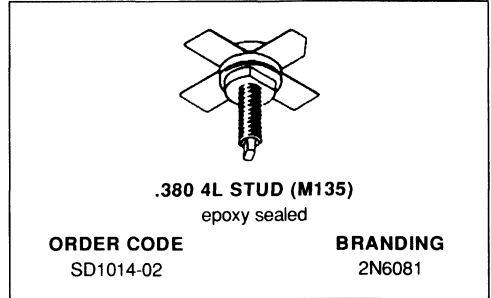


SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.385/9,78
F	.004/0,10	.006/0,15
G	.085/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48



**RF & MICROWAVE TRANSISTORS  
 VHF FM MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- HIGH EFFICIENCY
- COMMON EMITTER
- FM CLASS C TRANSISTOR
- $P_{OUT} = 15 \text{ W MIN. WITH } 6.3 \text{ dB GAIN}$


**DESCRIPTION**

The SD1014-02 is an epitaxial silicon NPN planar transistor designed primarily for VHF mobile and marine transmitters. The device utilizes emitter ballasting resistors and improved metallization systems to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	2.5	A
$P_{DISS}$	Power Dissipation	31	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.6	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

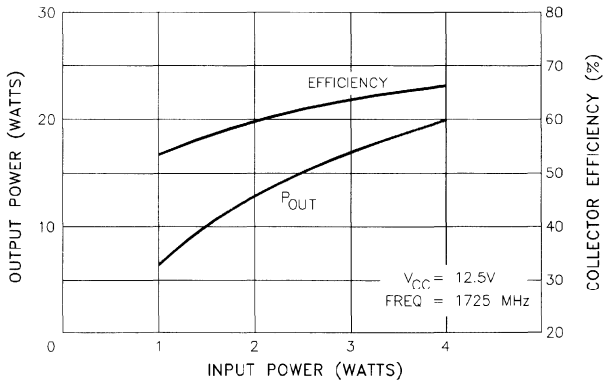
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 10mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 20mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	5	—	200	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175\text{ MHz}$	$P_{IN} = 3.5\text{ W}$	$V_{CE} = 12.5\text{ V}$	15	—	—	W
$G_P$	$f = 175\text{ MHz}$	$P_{IN} = 3.5\text{ W}$	$V_{CE} = 12.5\text{ V}$	6.3	—	—	dB
$\eta_C$	$f = 175\text{ MHz}$	$P_{OUT} = 15\text{ W}$	$V_{CE} = 12.5\text{ V}$	60	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 15\text{ V}$		—	—	85	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**



## IMPEDANCE DATA

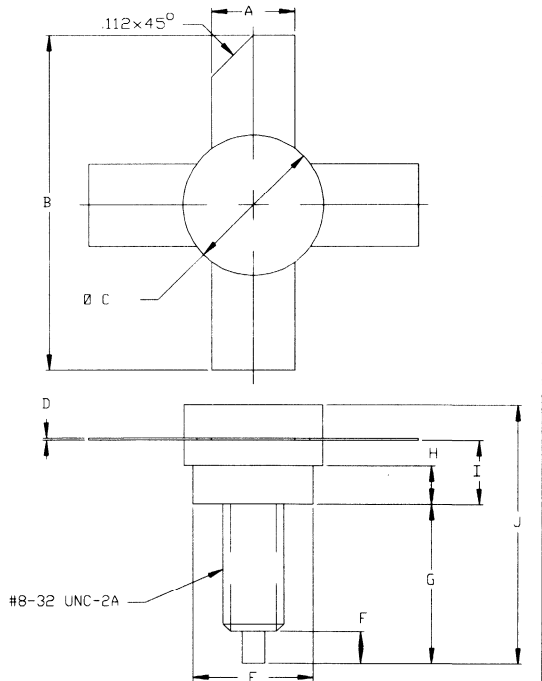
$P_{IN}$ (W)	$P_{OUT}$ (W)	$Z_{IN}$ ( $\Omega$ )	$Z_{OUT}$ ( $\Omega$ )
1	9.3	$0.8 - j 1.0$	$4.0 + j 3.0$
3	19.6	$1.0 - j 1.4$	$3.3 + j 1.2$
5	27.6	$1.0 - j 1.0$	$2.9 + j 0.6$

Freq. = 175 MHz  
 $V_{CC} = 12.5$  V

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0135

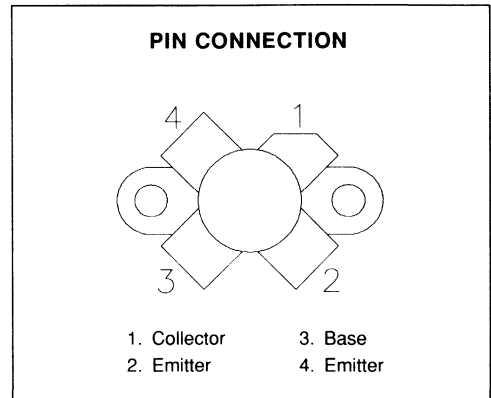
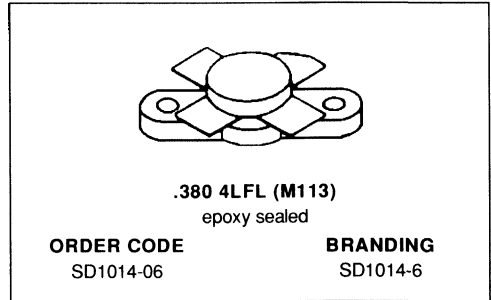
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05





**RF & MICROWAVE TRANSISTORS  
 VHF APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- EFFICIENCY 60%
- COMMON EMITTER
- $P_{OUT} = 15 \text{ W MIN. WITH } 6.3 \text{ dB GAIN}$


**DESCRIPTION**

This epitaxial silicon Class C NPN planar transistor is designed primarily for VHF mobile and marine transmitters. The device utilizes emitter ballasting resistors and improved metallization systems to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	2.5	A
$P_{DISS}$	Power Dissipation	31	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.6	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

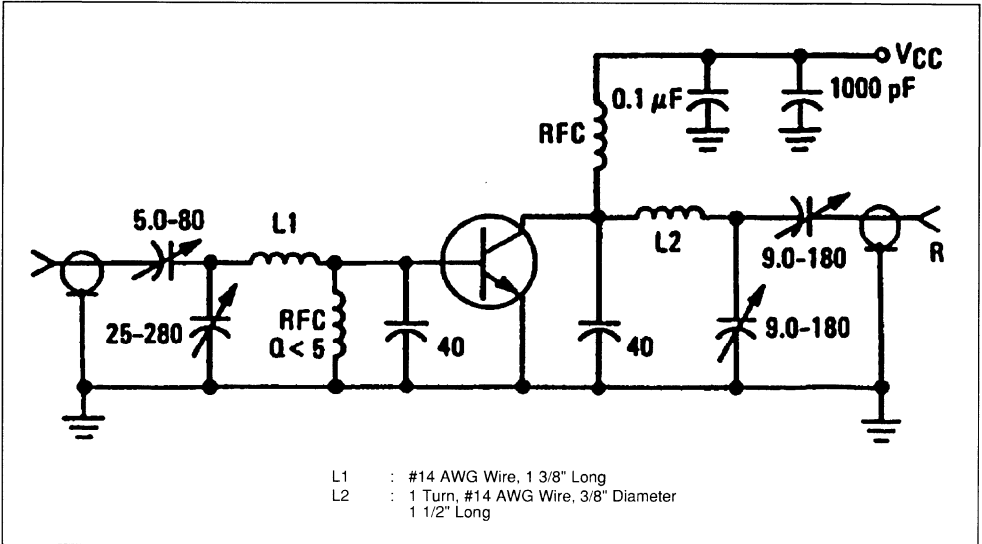
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 10mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 20mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	0.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	5	—	200	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175\text{ MHz}$	$P_{IN} = 3.5\text{ W}$	$V_{CC} = 12.5\text{ V}$	15	—	—	W
$\eta_c$	$f = 175\text{ MHz}$	$P_{IN} = 3.5\text{ W}$	$V_{CC} = 12.5\text{ V}$	60	—	—	%
$G_P$	$f = 175\text{ MHz}$	$P_{IN} = 3.5\text{ W}$	$V_{CC} = 12.5\text{ V}$	6.3	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 15\text{ V}$		—	—	85	pF

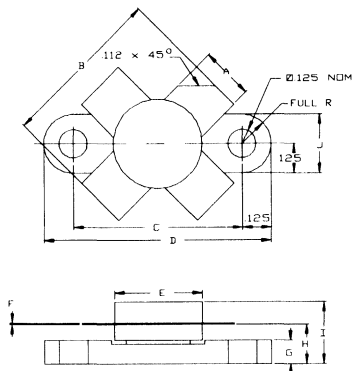
TEST CIRCUIT





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0113

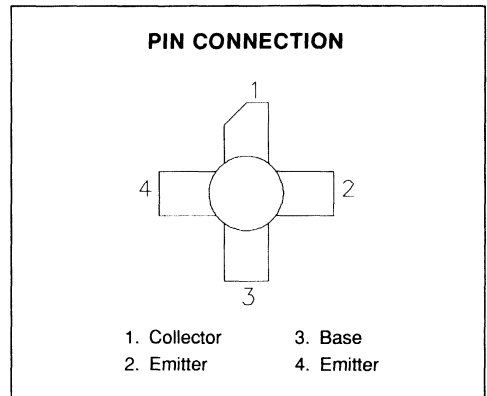
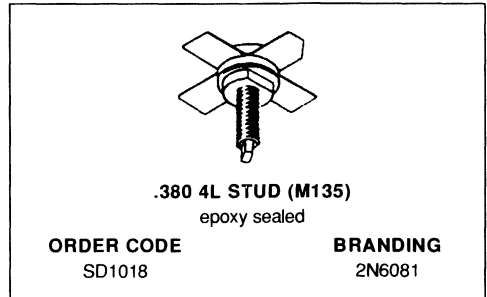


SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5.59	.230/5.84
B	.785/19.94	
C	.720/18.29	.730/18.54
D	.970/24.64	.980/24.89
E		.385/9.78
F	.004/0.10	.006/0.15
G	.085/2.16	.105/2.67
H	.160/4.06	.180/4.57
I		.280/7.11
J	.240/6.10	.255/6.48



**RF & MICROWAVE TRANSISTORS  
 VHF FM MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- HIGH EFFICIENCY
- COMMON EMITTER
- FM CLASS C TRANSISTOR
- $P_{OUT} = 40 \text{ W MIN. WITH } 4.5 \text{ dB GAIN}$


**DESCRIPTION**

The SD1018 is an epitaxial silicon NPN planar transistor designed primarily for VHF mobile and marine transmitters. The device utilizes emitter ballasting resistors and improved metallization systems to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	6.0	A
$P_{DISS}$	Power Dissipation	80	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.2	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

# SD1018 (2N6084)

## ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

### STATIC

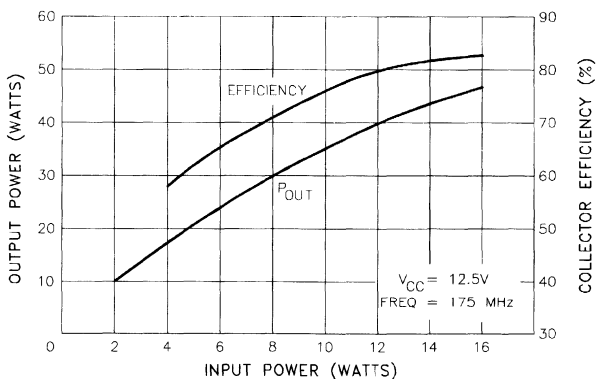
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 20mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 100mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	2.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	5	—	—	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175\text{ MHz}$	$P_{IN} = 14\text{ W}$	$V_{CE} = 12.5\text{ V}$	40	—	—	W
$G_P$	$f = 175\text{ MHz}$	$P_{IN} = 14\text{ W}$	$V_{CE} = 12.5\text{ V}$	4.5	—	—	dB
$\eta_c$	$f = 175\text{ MHz}$	$P_{OUT} = 40\text{ W}$	$V_{CE} = 12.5\text{ V}$	70	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 15\text{ V}$		—	—	200	pF

### TYPICAL PERFORMANCE

**POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**



## IMPEDANCE DATA

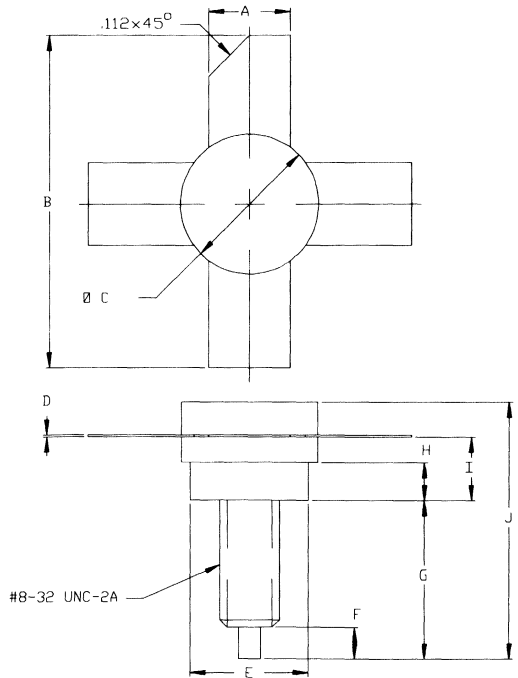
$P_{IN}$ (W)	$P_{OUT}$ (W)	$Z_{IN}$ ( $\Omega$ )	$Z_{OUT}$ ( $\Omega$ )
4	21.7	$0.8 - j 1.1$	$2.2 - j 0.3$
8	37.1	$0.8 - j 1.3$	$1.7 - j 0.5$
12	46.5	$0.8 - j 1.6$	$1.6 - j 0.3$

Freq. = 175 MHz  
 $V_{CC}$  = 12.5 V

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0135

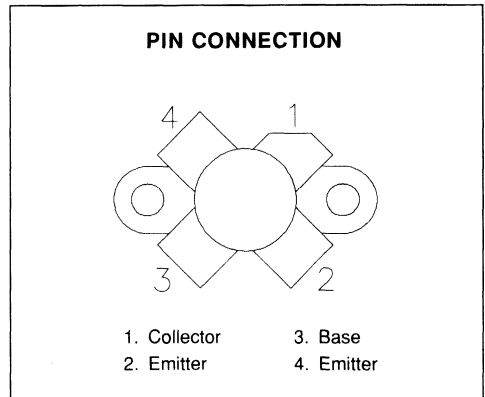
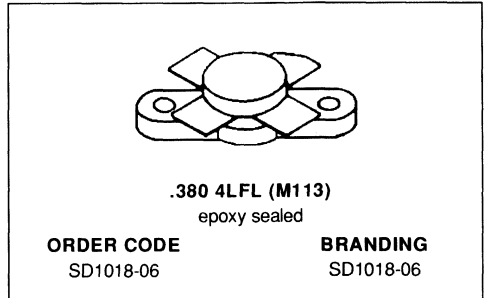
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05





**RF & MICROWAVE TRANSISTORS  
VHF MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- EFFICIENCY 70%
- COMMON EMITTER
- $P_{OUT} = 40 \text{ W MIN. WITH } 4.5 \text{ dB GAIN}$


**DESCRIPTION**

The SD1018-06 is an epitaxial silicon NPN planar transistor designed primarily for VHF mobile and marine transmitters. This device utilizes ballasted emitter resistors and improved metallization systems to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CER}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	6.0	A
$P_{DISS}$	Power Dissipation	80	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.2	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

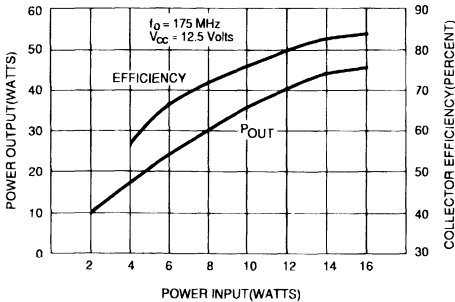
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 20mA$	$V_{BE} = 0mA$	36	—	—	V
$BV_{CEO}$	$I_C = 100mA$		18	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	2.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	5	—	—	—

DYNAMIC

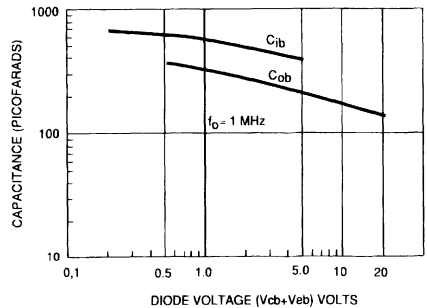
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175\text{ MHz}$	$P_{IN} = 14\text{ W}$	$V_{CC} = 12.5\text{ V}$	40	—	—	W
$\eta_C$	$f = 175\text{ MHz}$	$P_{IN} = 14\text{ W}$	$V_{CC} = 12.5\text{ V}$	70	—	—	%
$G_P$	$f = 175\text{ MHz}$	$P_{IN} = 14\text{ W}$	$V_{CC} = 12.5\text{ V}$	4.5	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 15\text{ V}$		—	—	200	pF

TYPICAL PERFORMANCE

**POWER OUTPUT vs POWER INPUT**



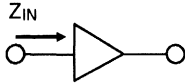
**CAPACITANCE vs VOLTAGE**



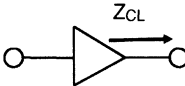


## IMPEDANCE DATA

### TYPICAL INPUT IMPEDANCE

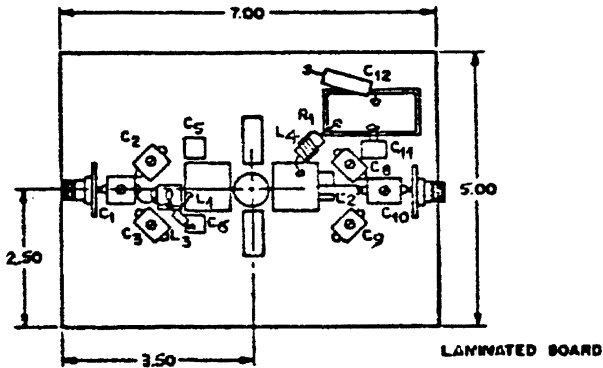


### TYPICAL COLLECTOR LOAD IMPEDANCE

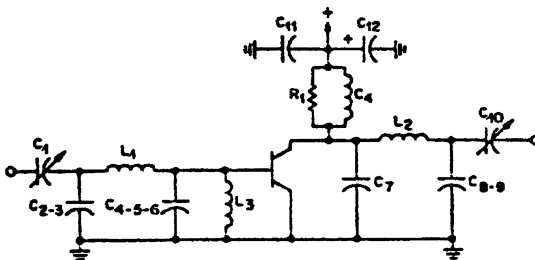


P <sub>IN</sub>	P <sub>OUT</sub>	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
4 W	21.7 W	0.8 - j 1.1	2.2 - j 0.3
8 W	37.1 W	0.8 - j 1.3	1.7 - j 0.5
12 W	46.5 W	0.8 - j 1.6	1.6 - j 0.3

## TEST CIRCUIT



1. Material: Epoxy Glass Board with Copper Lands for Base and Collector Contacts
2. Clamp: DE-STA-CO No. 205S



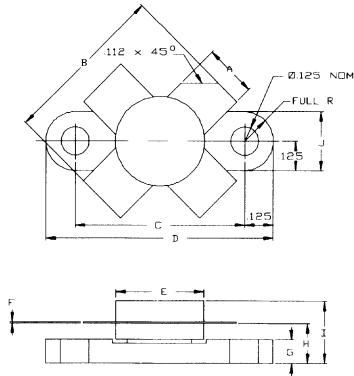
- |           |                |     |   |
|-----------|----------------|-----|---|
| C1        | : ARCO 462     | L1  | : 1 1/2 Turns #14 AWG,<br>1/4" I.D. x 1/2" Long |
| C2,C3,C4  | : ARCO 403     | L2* | : 1/8" Wide Brass Strap x 1 1/2" Long           |
| C4,C5,C6  | : Unelco 100pF | L3  | : Ferrite Bead 48                               |
| C7        | : Unelco 200pF | L4  | : 4 Turns, #16 AWG, 3/4" Long<br>Wound on R1    |
| C8,C9,C10 | : ARCO 404     | R1  | : 510Ω  |
| C11       | : Unelco 500pF |     |   |
| C12       | : 33μF 15V     |     |   |

L2\*



PACKAGE MECHANICAL DATA

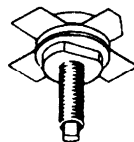
Ref.: Dwg. No.12-0113



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.395/9,78
F	.004/0,10	.006/0,15
G	.095/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48

**RF & MICROWAVE TRANSISTORS  
 VHF APPLICATIONS**

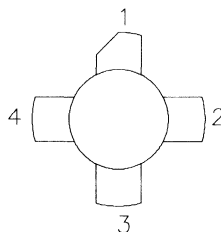
- 136 MHz
- 13.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 30 \text{ W MIN. WITH } 4.5 \text{ dB GAIN}$



**.500 4L STUD (M130)**  
 epoxy sealed

**ORDER CODE**  
 SD1019

**BRANDING**  
 SD1019

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

**DESCRIPTION**

The SD1019 is a 28 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. This device utilizes nichrome aluminum metallization to achieve infinite VSWR at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	35	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	9.0	A
$P_{DISS}$	Power Dissipation	117	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.7	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

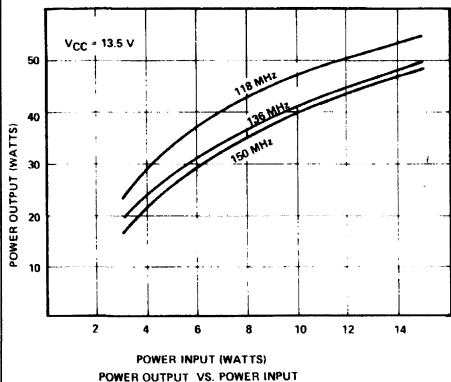
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 20\text{mA}$	$I_{\text{E}} = 0\text{mA}$	65	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 200\text{mA}$	$I_{\text{B}} = 0\text{mA}$	35	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	1.5	—	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 500\text{mA}$	5	—	—	—

## DYNAMIC

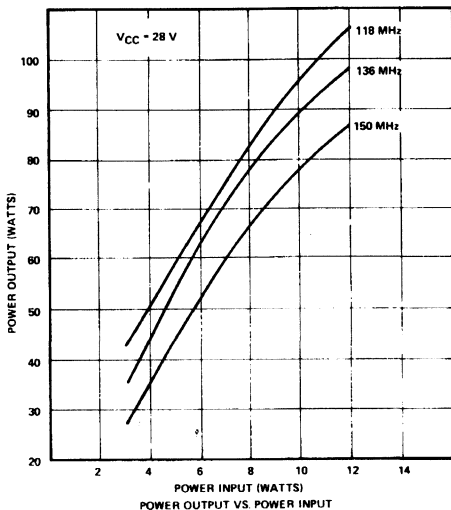
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 150\text{ MHz}$	$P_{\text{IN}} = 10.6\text{ W}$	$V_{\text{CC}} = 13.5\text{ V}$	30	—	—	W
$G_{\text{P}}$	$f = 150\text{ MHz}$	$P_{\text{IN}} = 10.6\text{ W}$	$V_{\text{CC}} = 13.5\text{ V}$	4.5	—	—	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 30\text{ V}$		—	—	150	pF

TYPICAL PERFORMANCE

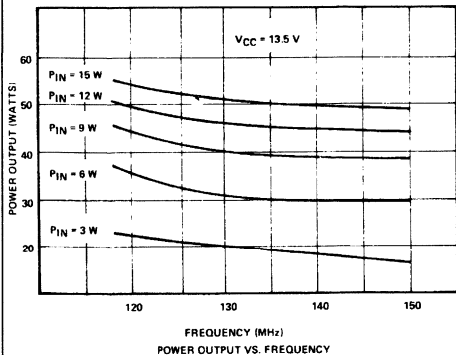
POWER OUTPUT vs POWER INPUT (13.5V)



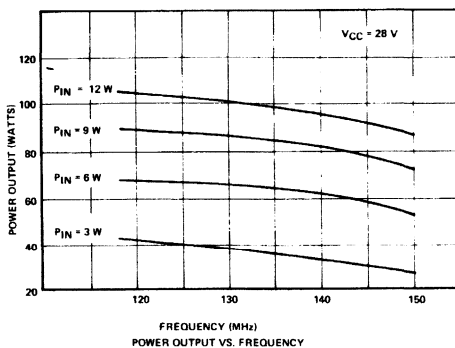
POWER OUTPUT vs POWER INPUT (28V)



POWER OUTPUT vs FREQUENCY (13.5V)

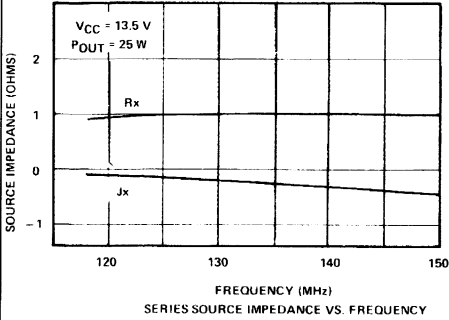


POWER OUTPUT vs FREQUENCY (28V)

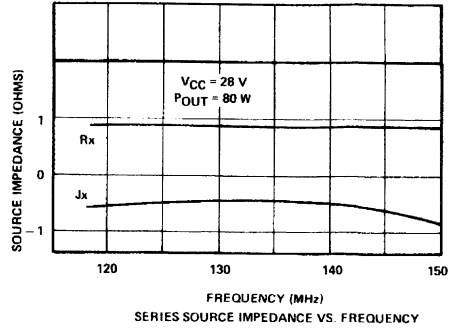


IMPEDANCE DATA

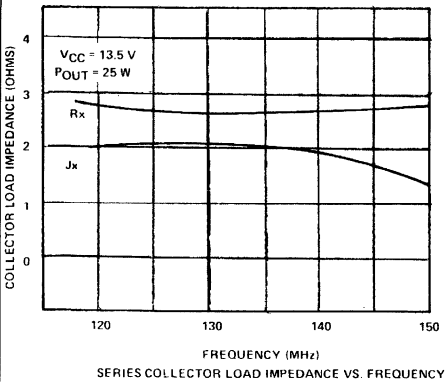
TYPICAL INPUT IMPEDANCE (13.5 V)



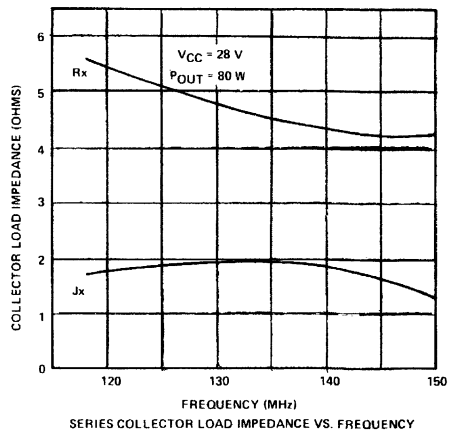
TYPICAL INPUT IMPEDANCE (28 V)



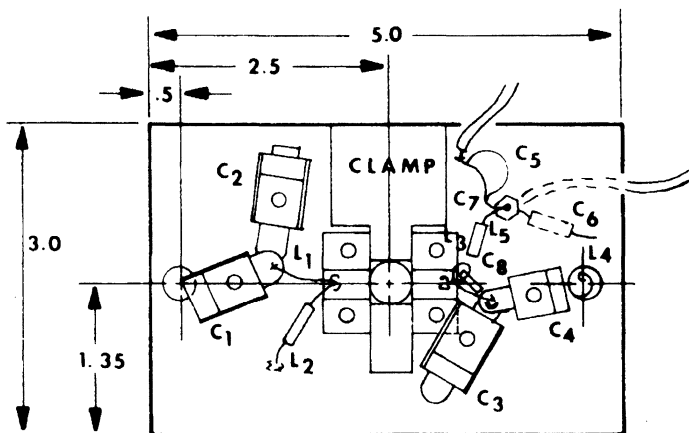
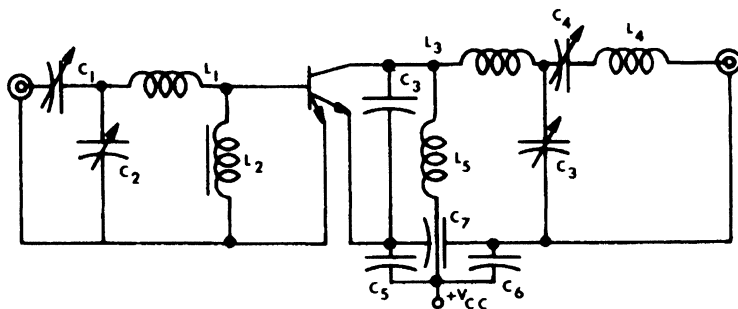
TYPICAL COLLECTOR LOAD IMPEDANCE (13.5 V)



TYPICAL COLLECTOR LOAD IMPEDANCE (28 V)



## TEST CIRCUIT

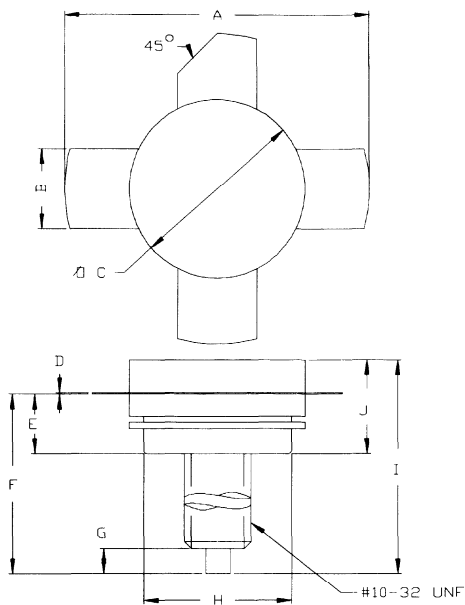


C1	: ARCO 462	L1	: #14 AWG. Wire, .3" Long
C2,C3,C4	: ARCO 463	L2	: 12mH Choke
C5	: .02 $\mu$ F Erie	L3	: 1 Turn, #20 AWG. Wire, .3" I.D., .25" Long
C6	: 15 $\mu$ F Semcor	L4	: 1 Turn, #16 AWG. Wire, .23" I.D., .1" Long
C7	: AB 220pF Feedthru	L5	: .22mH Deci-Ductor
C8	: 150pF Unelco		

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0130

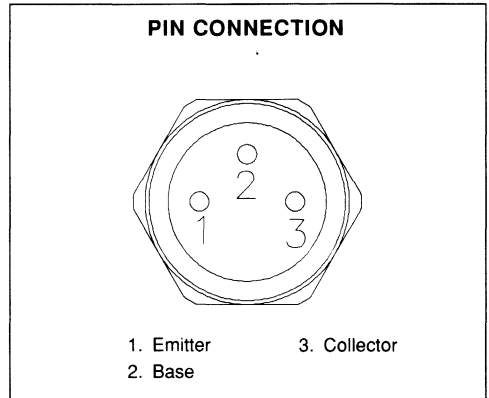
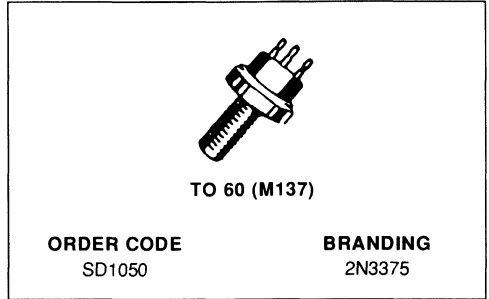
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.050/26,67
B	.220/5,59	.230/5,84
C	.495/12,57	.505/12,83
D	.003/0,08	.007/0,18
E	.160/4,06	.180/4,57
F	.622/15,80	
G	.100/2,54	.130/3,31
H	.415/10,54	.425/10,80
I	.720/18,29	
J	.250/6,35	.290/7,37





## RF & MICROWAVE TRANSISTORS VHF-UHF APPLICATIONS

- 130 - 400 MHz
- 28 VOLTS
- HIGH POWER GAIN
- HIGH EFFICIENCY
- COMMON EMITTER
- $P_{OUT} = 3 \text{ W MIN. @ } 400 \text{ MHz}$



### DESCRIPTION

This line of silicon epitaxial NPN planar high frequency transistor employs a multi emitter electrode design. This feature together with a heavily diffused base matrix located between the individual emitters results in high RF current handling capability, high power gain, low base resistance and low output capacitance. These transistors are intended for Class A, B, or C amplifier, oscillator or frequency multiplier circuits and are specifically designed for operation in the VHF-UHF region

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CB0}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	40	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	1.5	A
$P_{DISS}$	Power Dissipation (+25°C)	11.6	W
$T_J$	Junction Temperature	+200	°C
$T_{STG}$	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	15.0	°C/W
---------------	----------------------------------	------	------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

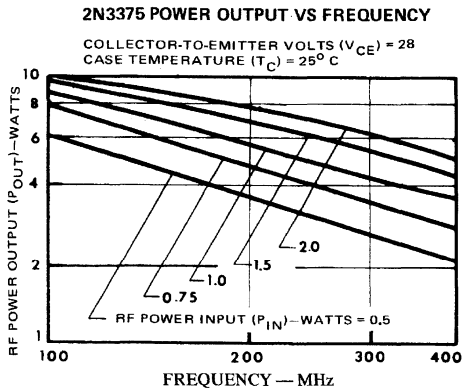
STATIC

Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 0.5mA$	65	—	—	V
$BV_{EBO}$	$I_E = 0.1mA$	4	—	—	V
$BV_{CEO}$	$I_C = 200mA$	40	—	—	V
$I_{CEO}$	$V_{CE} = 30V$	—	—	0.1	mA
$h_{FE}$	$V_{CE} = 5V$ $I_C = 250mA$	10	—	—	—

DYNAMIC

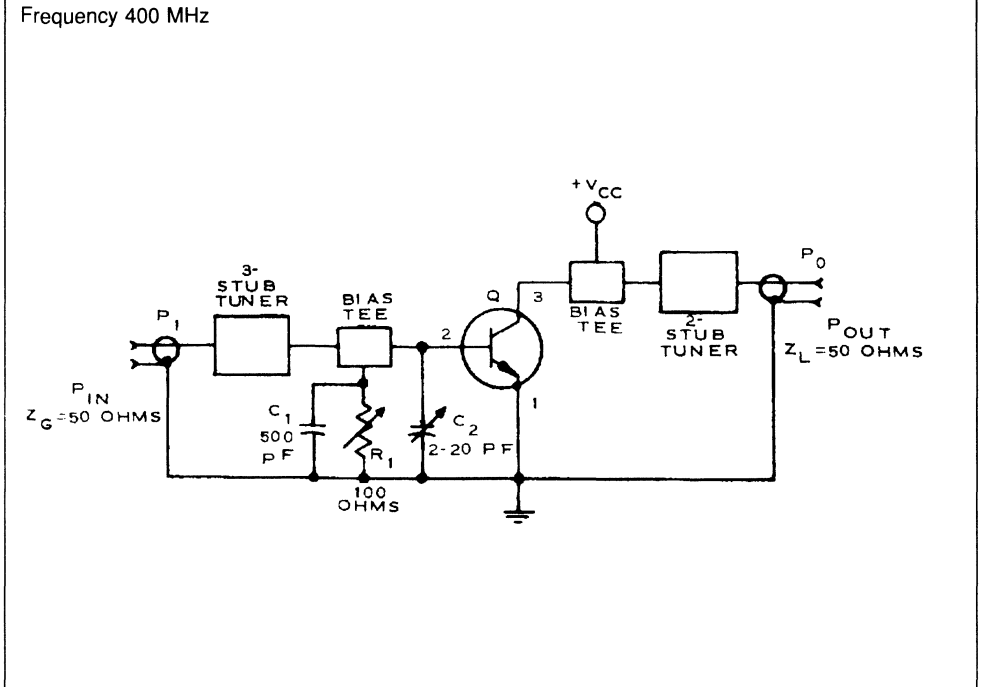
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 400\text{ MHz}$	$P_{IN} = 1\text{ W}$	$V_{CC} = 28\text{ V}$	3	—	—	W
$\eta_c$	$f = 400\text{ MHz}$	$P_{IN} = 1\text{ W}$	$V_{CC} = 28\text{ V}$	40	—	—	%
GP	$f = 400\text{ MHz}$	$P_{IN} = 1\text{ W}$	$V_{CC} = 28\text{ V}$	4.8	—	—	dB
COB	$f = 1\text{ MHz}$	$V_{CB} = 30\text{ V}$		—	—	10	pF

TYPICAL PERFORMANCE



## TEST CIRCUIT

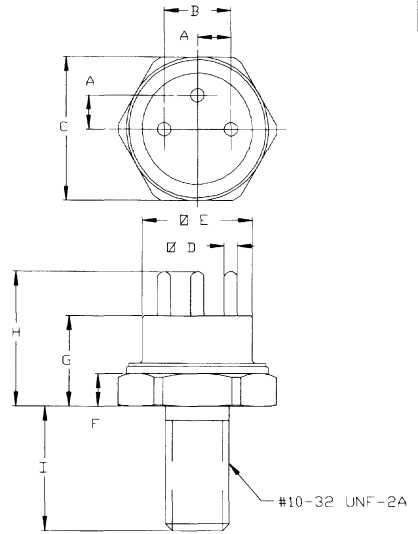
Frequency 400 MHz



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0137

SGS-THOMSON MICROELECTRONICS			
	MINIMUM Inches/mm	MAXIMUM Inches/mm	
A	.090/2,29	.110/2,79	
B	.185/4,70	.215/5,46	
C	.420/10,67	.440/11,18	
D	.030/0,76	.046/1,17	
E	.320/8,13	.360/9,14	
F	.090/2,29	.135/3,43	
G	.215/5,46	.320/8,13	
H		.480/12,19	
I	.420/10,67	.455/11,56	← STANDARD STUD
I	.140/3,56	.160/4,06	← SHORT STUD



## RF & MICROWAVE TRANSISTORS VHF-UHF APPLICATIONS

- 400 MHz
- 28 VOLTS
- EFFICIENCY 45% MIN.
- $P_{OUT} = 5.0 \text{ W MIN. WITH } 4.7 \text{ dB GAIN}$



TO 60 (M137)

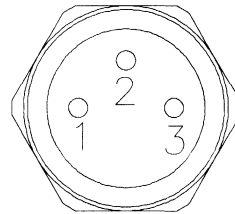
**ORDER CODE**  
SD1060

**BRANDING**  
2N4440

### DESCRIPTION

This silicon epitaxial NPN planar high frequency transistor employs a multi emitter electrode design. This feature together with a heavily diffused base matrix located between the individual emitters results in high RF current handling capability, high power gain, low base resistance and low output capacitance. These transistors are intended for Class A, B, or C amplifier, oscillator or frequency multiplier circuits and are specifically designed for operation in the VHF-UHF region

### PIN CONNECTION



1. Emitter                      3. Collector  
2. Base

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	65	V
V <sub>CEO</sub>	Collector-Emitter Voltage	40	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	1.5	A
P <sub>DISS</sub>	Power Dissipation	11.6	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	15.1	°C/W
----------------------	----------------------------------	------	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

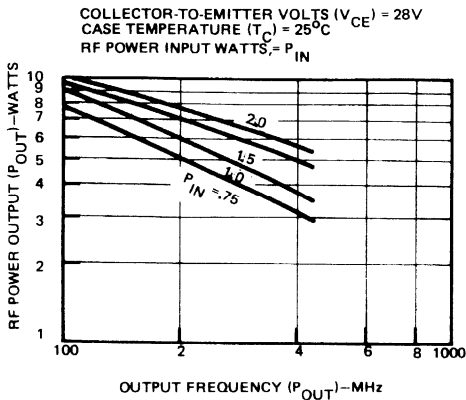
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 100\mu A$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	4.0	—	—	V
$BV_{CEO}$	$I_C = 200mA$	40	—	—	V
$I_{CEO}$	$V_{CE} = 30V$	—	—	0.1	mA

**DYNAMIC**

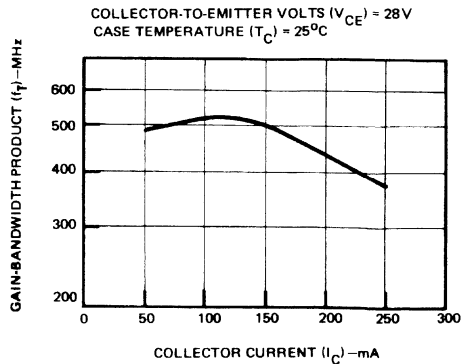
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 400\text{ MHz}$	$P_{IN} = 1.7\text{ W}$	$V_{CC} = 28\text{ V}$	5.0	—	—	W
$\eta_C$	$f = 400\text{ MHz}$	$P_{IN} = 1.7\text{ W}$	$V_{CC} = 28\text{ V}$	45	—	—	%
GP	$f = 400\text{ MHz}$	$P_{IN} = 1.7\text{ W}$	$V_{CC} = 28\text{ V}$	4.7	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 30\text{ V}$		—	—	10.0	pF

**TYPICAL PERFORMANCE**

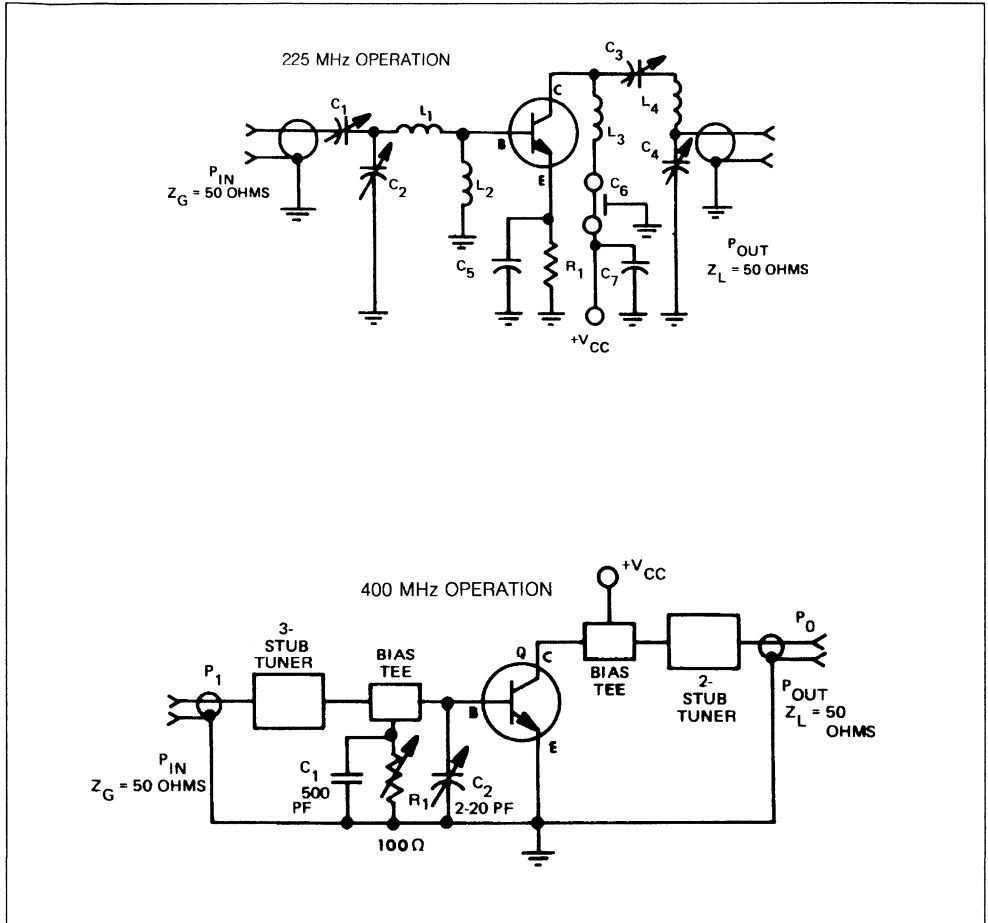
**POWER OUTPUT vs FREQUENCY**



**POWER GAIN vs COLLECTOR CURRENT**



## TEST CIRCUIT



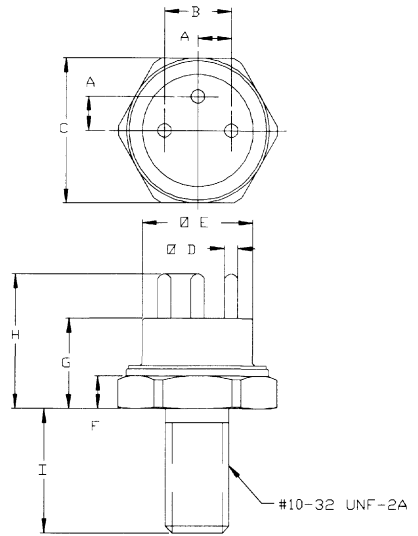
PACKAGE MECHANICAL DATA

Ref.: Dwg. No. 12-0137

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.090/2,29	.110/2,79
B	.185/4,70	.215/5,46
C	.420/10,67	.440/11,18
D	.030/0,76	.046/1,17
E	.320/8,13	.360/9,14
F	.090/2,29	.135/3,43
G	.215/5,46	.320/8,13
H		.480/12,19
I	.420/10,67	.455/11,56
I	.140/3,56	.160/4,06

← STANDARD STUD

← SHORT STUD





## RF & MICROWAVE TRANSISTORS VHF-UHF APPLICATIONS

- 130 - 400 MHz
- 28 VOLTS
- HIGH POWER GAIN
- HIGH EFFICIENCY
- COMMON EMITTER
- $P_{OUT} = 13.5 \text{ W MIN. @ } 175 \text{ MHz}$



TO 60 (M137)

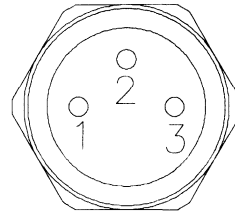
**ORDER CODE**  
SD1070

**BRANDING**  
2N3632

### DESCRIPTION

This silicon epitaxial NPN planar high frequency transistor employs a multi emitter electrode design. This feature together with a heavily diffused base matrix located between the individual emitters results in high RF current handling capability, high power gain, low base resistance and low output capacitance. These transistors are intended for Class A, B, or C amplifier, oscillator or frequency multiplier circuits and are specifically designed for operation in the VHF-UHF region

### PIN CONNECTION



1. Emitter                      3. Collector  
2. Base

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	65	V
V <sub>CES</sub>	Collector-Emitter Voltage	40	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	3.0	A
P <sub>DISS</sub>	Power Dissipation	23.0	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	7.6	°C/W
----------------------	----------------------------------	-----	------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

STATIC

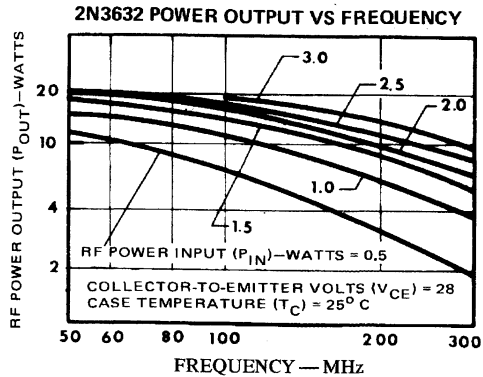
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 0.5mA$	65	—	—	V
$BV_{EBO}$	$I_E = 0.25mA$	4	—	—	V
$BV_{CEO}$	$I_C = 200mA$	40	—	—	V
$I_{CEO}$	$V_{CE} = 30V$	—	—	0.25	mA
$h_{FE}$	$V_{CE} = 5V$ $I_C = 1A$	5	—	—	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175\text{ MHz}$	$P_{IN} = 3.5\text{ V}$	$V_{CC} = 28\text{ V}$	13.5	—	—	W
$\eta_C$	$f = 175\text{ MHz}$	$P_{IN} = 3.5\text{ V}$	$V_{CC} = 28\text{ V}$	70	—	—	%
$G_P$	$f = 175\text{ MHz}$	$P_{IN} = 3.5\text{ V}$	$V_{CC} = 28\text{ V}$	5.8	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 30\text{ V}$		—	—	20	pF

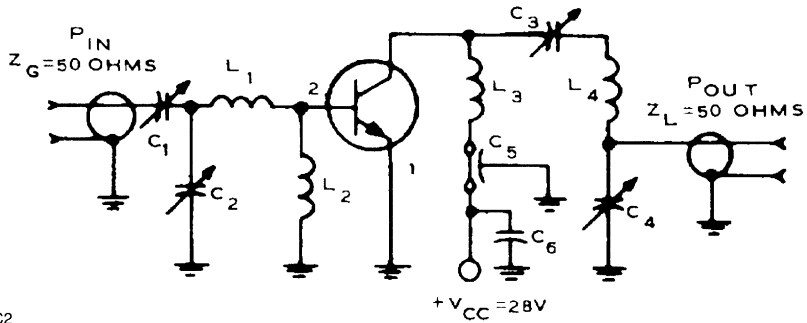
TYPICAL PERFORMANCE

POWER OUTPUT vs FREQUENCY



## TEST CIRCUIT

Frequency 175MHz



- $C_1, C_2$   
 $C_3, C_4$  : 7 - 100pF  
 $C_5$  : 100pF  
 $C_6$  : 0.01 $\mu\text{F}$ , Disc Ceramic  
 $L_1$  : 1.5 Turns #16 Wire, 3/16" I.D., 5/16" Long  
 $L_2$  : Ferrite Choke,  $Z = 450$   
 $L_3$  : 1 Turn #16 Wire, 1/4" I.D., 3/8" Long  
 $L_4$  : 2 Turns #16 Wire, 1/4" I.D., 1/4" Long

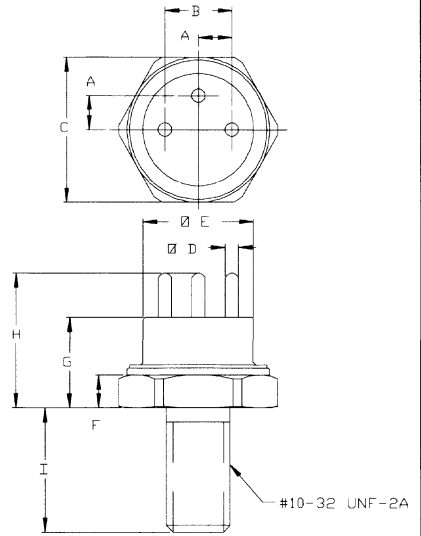
PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0137

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.090/2,29	.110/2,79
B	.185/4,70	.215/5,46
C	.420/10,67	.440/11,18
D	.030/0,76	.046/1,17
E	.320/8,13	.360/9,14
F	.090/2,29	.135/3,43
G	.215/5,46	.320/8,13
H		.480/12,19
I	.420/10,67	.455/11,56
I	.140/3,56	.160/4,06

← STANDARD STUD

← SHORT STUD



**RF & MICROWAVE TRANSISTORS  
 VHF-UHF APPLICATIONS**

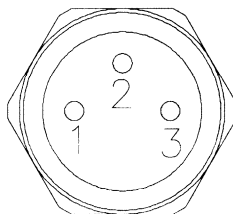
- 130 - 400 MHz
- 28 VOLTS
- HIGH POWER GAIN
- HIGH EFFICIENCY
- COMMON EMITTER
- $P_{OUT} = 10 \text{ W MIN. @ } 400 \text{ MHz}$


**TO 60 (M137)**
**ORDER CODE**  
 SD1075

**BRANDING**  
 2N3733

**DESCRIPTION**

This line of silicon epitaxial NPN planar high frequency transistor employs a multi emitter electrode design. This feature together with a heavily diffused base matrix located between the individual emitters results in high RF current handling capability, high power gain, low base resistance and low output capacitance. These transistors are intended for Class A, B, or C amplifier, oscillator or frequency multiplier circuits and are specifically designed for operation in the VHF-UHF region

**PIN CONNECTION**


1. Emitter
2. Base
3. Collector

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	40	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	3.0	A
$P_{DISS}$	Power Dissipation	23.0	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	7.6	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

# SD1075 (2N3733)

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

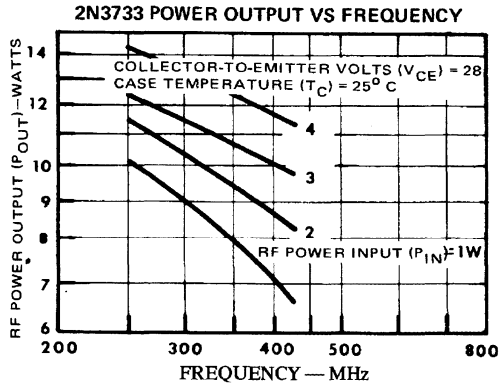
### STATIC

Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 0.5mA	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 0.25mA	4	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 200mA	40	—	—	V
I <sub>CEO</sub>	V <sub>CE</sub> = 30V	—	—	0.25	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V I <sub>C</sub> = 250mA	10	—	150	—

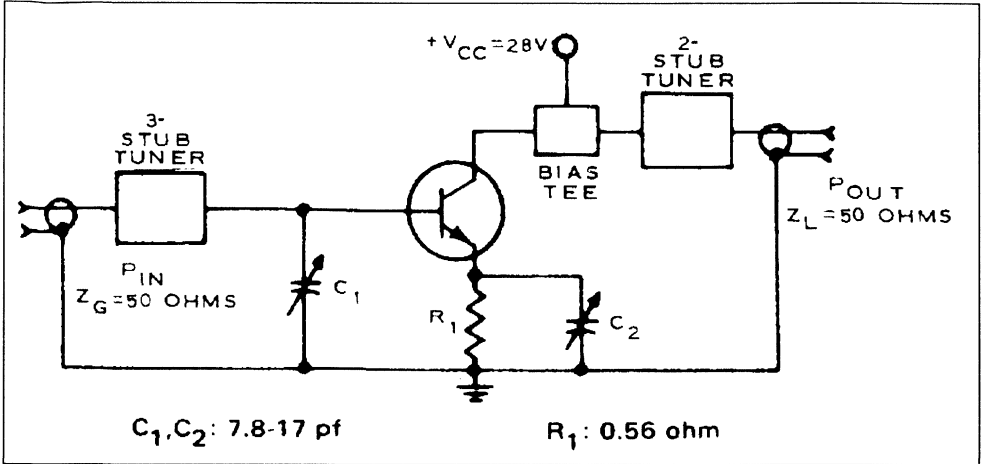
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 400 MHz	P <sub>IN</sub> = 4 V	V <sub>CC</sub> = 28 V	10	—	—	W
η <sub>c</sub>	f = 400 MHz	P <sub>IN</sub> = 4 V	V <sub>CC</sub> = 28 V	45	—	—	%
G <sub>P</sub>	f = 400 MHz	P <sub>IN</sub> = 4 V	V <sub>CC</sub> = 28 V	4.0	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 30 V		—	—	20	pF

### TYPICAL PERFORMANCE



## TEST CIRCUIT



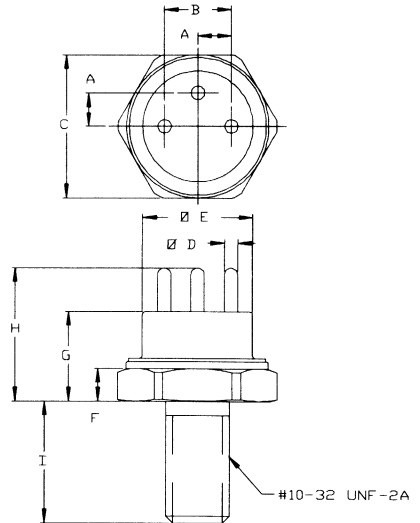
## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0137

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.090/2,29	.110/2,79
B	.185/4,70	.215/5,46
C	.420/10,67	.440/11,18
D	.030/0,76	.046/1,17
E	.320/8,13	.360/9,14
F	.090/2,29	.135/3,43
G	.215/5,46	.320/8,13
H		.480/12,19
I	.420/10,67	.455/11,56
I	.140/3,56	.160/4,06

← STANDARD STUD

← SHORT STUD

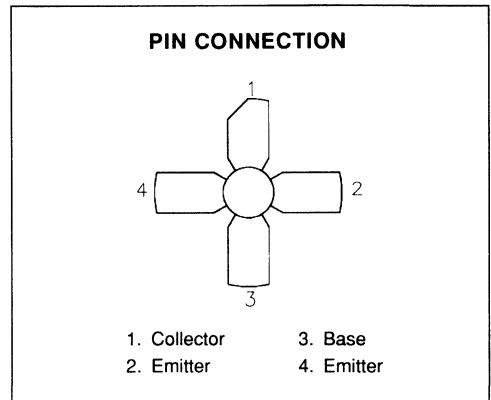
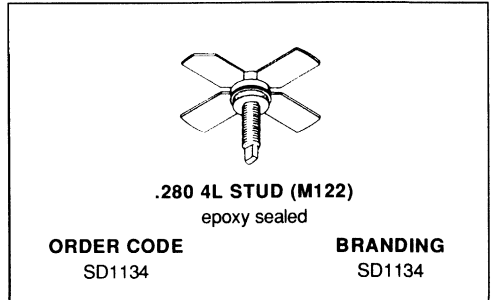






**RF & MICROWAVE TRANSISTORS  
 UHF MOBILE APPLICATIONS**

- 450 - 512 MHz
- 12.5 VOLTS
- EFFICIENCY 55%
- COMMON EMITTER
- $P_{OUT} = 2.0$  W MIN. WITH 10.0 dB GAIN


**DESCRIPTION**

The SD1134 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for UHF communications. This device utilizes improved metallization to achieve infinite VSWR at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	16	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	0.75	A
$P_{DISS}$	Power Dissipation	5	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	35	$^{\circ}C/W$
---------------	----------------------------------	----	---------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

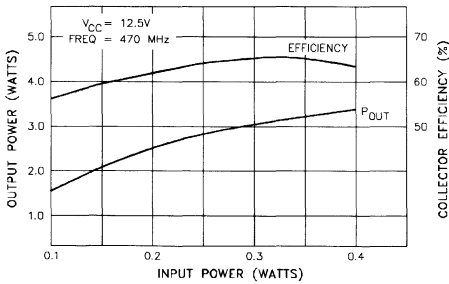
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 5mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 25mA	I <sub>B</sub> = 0mA	16	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 15V	I <sub>E</sub> = 0mA	—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 100mA	20	—	—	—

DYNAMIC

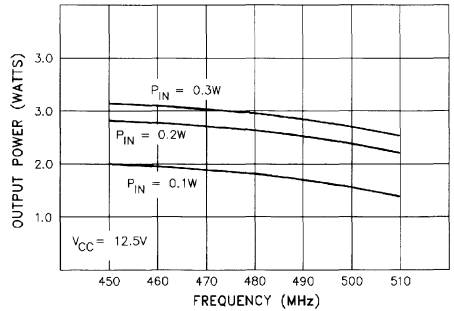
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 470 MHz	P <sub>IN</sub> = 0.20 W	V <sub>CC</sub> = 12.5 V	2.0	—	—	W
G <sub>P</sub>	f = 470 MHz	P <sub>IN</sub> = 0.20 W	V <sub>CC</sub> = 12.5 V	10.0	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12 V		—	6	—	pF

TYPICAL PERFORMANCE

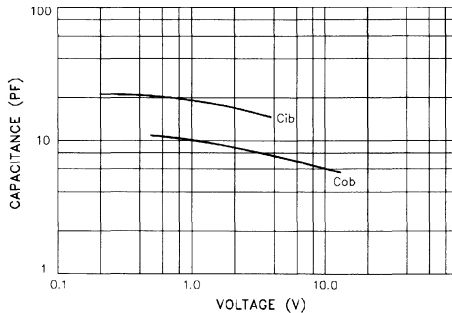
POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT



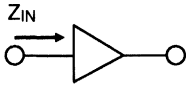
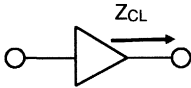
POWER OUTPUT vs FREQUENCY



CAPACITANCE vs VOLTAGE

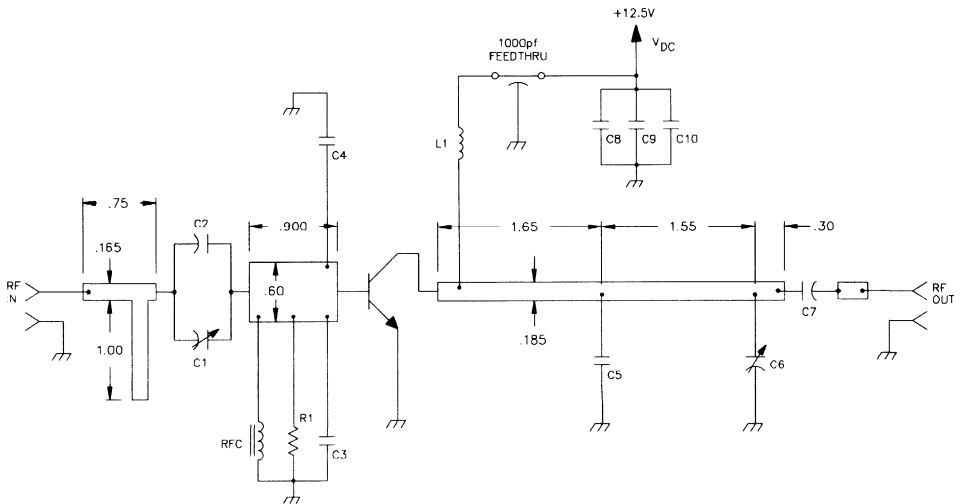


## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
450 MHz	$2.7 + j 0.9$	$11.5 - j 15.0$
470 MHz	$2.6 + j 1.3$	$12.2 - j 13.5$
512 MHz	$2.2 + j 1.7$	$12.7 - j 13.0$

## TEST CIRCUIT



- C1 : 0.8-10pF, Voltronics AJ10  
 C2 : ATC 100-B, 7.5pF, Chip Capacitor  
 C3, C4 : ATC 100-B, 24pF, Chip Capacitor  
 C5 : ATC 100-B, 5.6pF, Chip Capacitor  
 C6 : 0.6-6pF, Johanson  
 C7 : ATC 100-B, 200pF, Chip Capacitor  
 C8 : 5.6 $\mu$ F Electrolytic

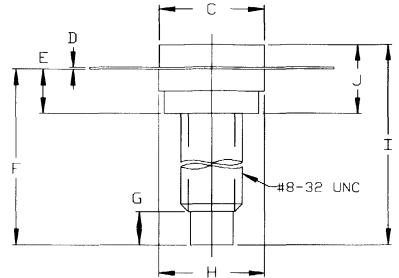
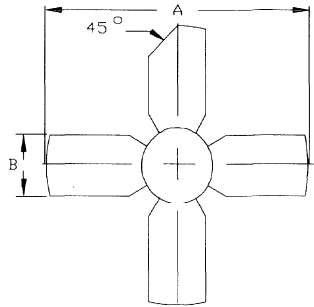
- C9 : 0.1 $\mu$ F, Disc-Ceramic  
 C10 : 0.01 $\mu$ F, Disc-Ceramic  
 L1 : 2 Turns #22 Enameled 0.1" I.D.  
 R1 : 360 $\Omega$ , 1/4" Wide  
 RFC : 2 Turns in Ferroxcube VK 200/19-4B

Board Material: 3M-K-6098 1/16" Thick

PACKAGE MECHANICAL DATA

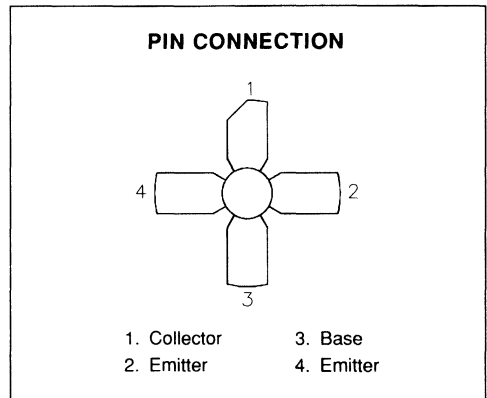
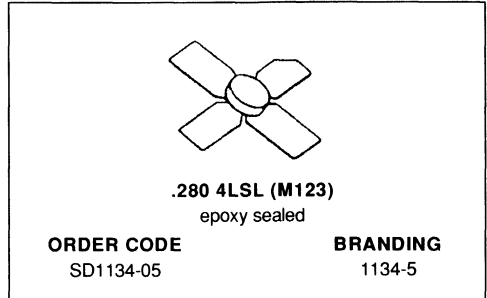
Ref.: Dwg. No.12-0122

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51



**RF & MICROWAVE TRANSISTORS  
 VHF PORTABLE/MOBILE APPLICATIONS**

- 175 MHz
- 7.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 0.5 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1134-05 is a 7.5 V epitaxial silicon NPN planar transistor designed primarily for VHF communications. It with stands very high VSWR under rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CER}$	Collector-Emitter Voltage	16	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	0.75	A
$P_{DISS}$	Power Dissipation	5.0	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	35	$^{\circ}\text{C/W}$
---------------	----------------------------------	----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CES}}$	$I_{\text{C}} = 5\text{mA}$	$V_{\text{BE}} = 0\text{V}$	36	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 25\text{mA}$	$I_{\text{B}} = 0\text{mA}$	16	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CER}}$	$V_{\text{CE}} = 10\text{V}$	$R_{\text{BE}} = 80\Omega$	—	—	0.5	mA
$I_{\text{CBO}}$	$V_{\text{CB}} = 15\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	1.0	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$	40	—	200	—

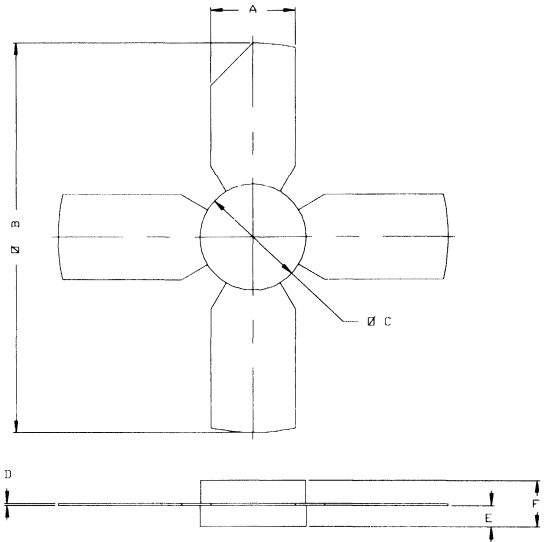
## DYNAMIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 150\text{ MHz}$	$V_{\text{CC}} = 7.5\text{ V}$	1.4	—	—	W
$G_{\text{P}}$	$f = 150\text{ MHz}$	$V_{\text{CC}} = 7.5\text{ V}$	11.5	—	—	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 7.5\text{ V}$	—	6.0	—	pF

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0123

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	220/5,59	230/5,84
B	-----	1.055/26,8
C	275/6,99	285/7,24
D	.004/0,10	.006/0,15
E	050/1,27	060/1,52
F	118/3,00	130/3,30

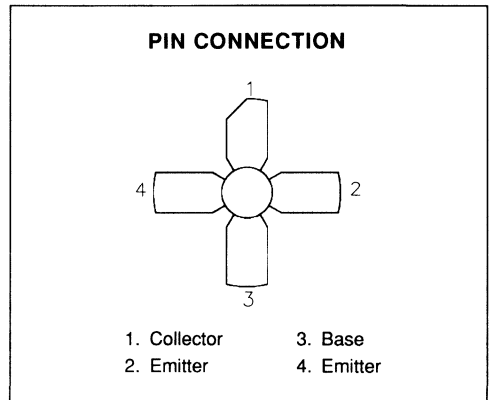
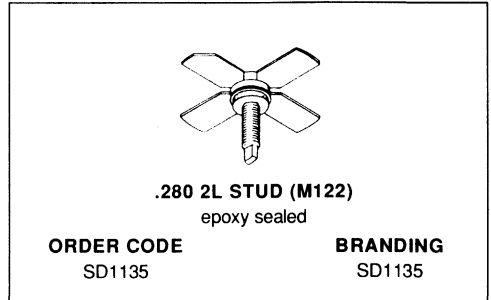






**RF & MICROWAVE TRANSISTORS  
 UHF MOBILE APPLICATIONS**

- 470 MHz
- 12.5 VOLTS
- EFFICIENCY 60%
- COMMON EMITTER
- $P_{OUT} = 5.0 \text{ W MIN. WITH } 8.5 \text{ dB GAIN}$


**DESCRIPTION**

The SD1135 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for UHF communications. This device utilizes improved metallization to achieve infinite VSWR at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CER}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	37	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	11.6	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

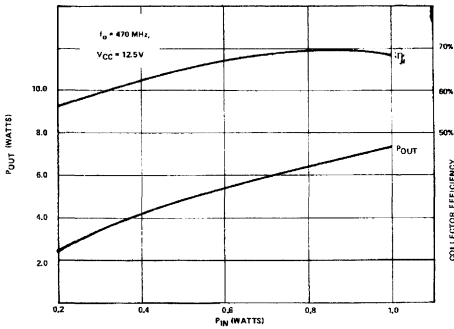
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 10mA$	$V_{BE} = 0mA$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	16	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 200mA$	20	—	—	—

**DYNAMIC**

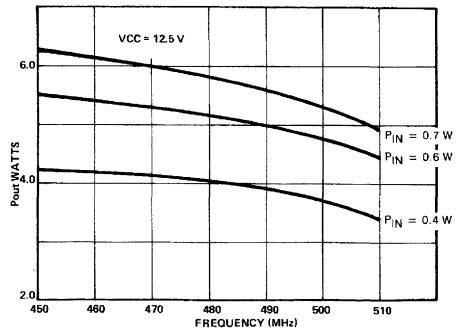
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 470\text{ MHz}$	$P_{IN} = 0.70\text{ W}$	$V_{CC} = 12.5\text{ V}$	5.0	—	—	W
$G_P$	$f = 470\text{ MHz}$	$P_{IN} = 0.70\text{ W}$	$V_{CC} = 12.5\text{ V}$	8.5	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 12\text{ V}$		—	19	—	pF

**TYPICAL PERFORMANCE**

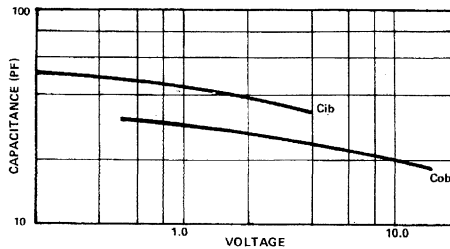
**POWER OUTPUT vs POWER INPUT**



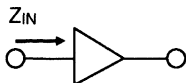
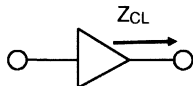
**POWER OUTPUT vs FREQUENCY**



**CAPACITANCE vs VOLTAGE**

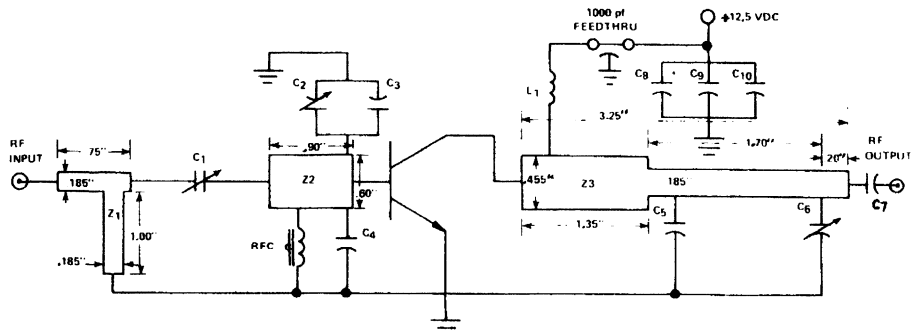
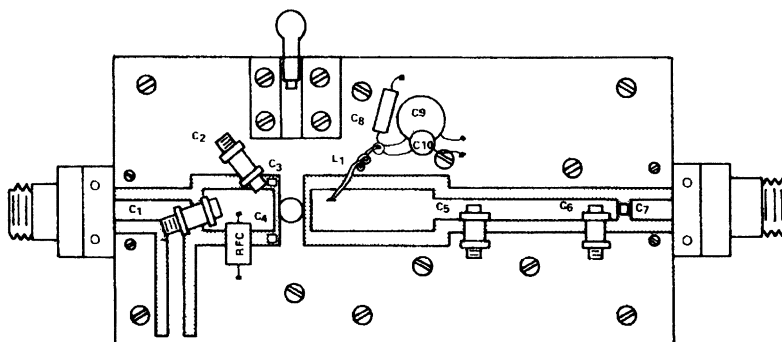


## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
450 MHz	$1.4 + j 2.0$	$10.7 - j 6.9$
470 MHz	$1.4 + j 2.9$	$11.4 - j 5.8$
512 MHz	$1.5 + j 3.4$	$11.9 - j 3.2$

## TEST CIRCUIT



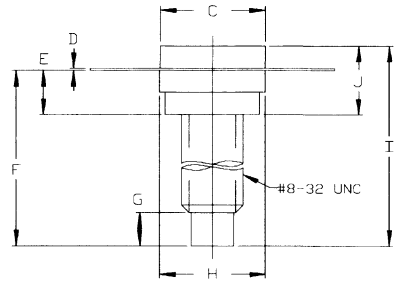
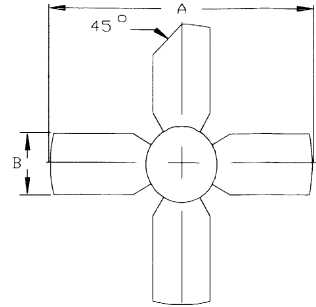
C1,C2 : 0.8-10pF, Voltronics AJ10  
 C3,C4 : ATC 100-B, 16pF, Chip Capacitor  
 C7 : ATC 100-B, 620pF, Chip Capacitor  
 C8 : 5.6 $\mu$ F, 35V, Electrolytic

C9 : 0.1 $\mu$ F, Disc-Ceramic  
 C10 : 0.01 $\mu$ F, Disc-Ceramic  
 L1 : 2 Turns, #22 Enameled, 0.1" I.D.  
 RFC : 2 Turns in Ferroxcube VK 200/19-4B

Board Material 3M-K-6098, 1/16" Thick

PACKAGE MECHANICAL DATA

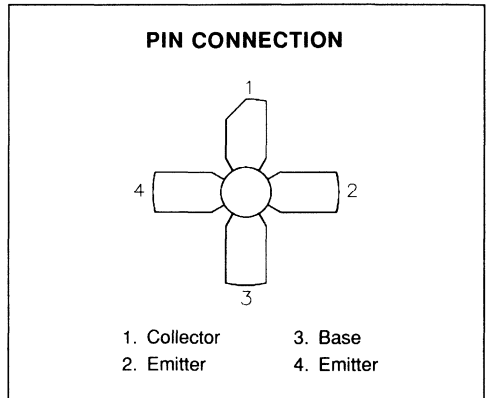
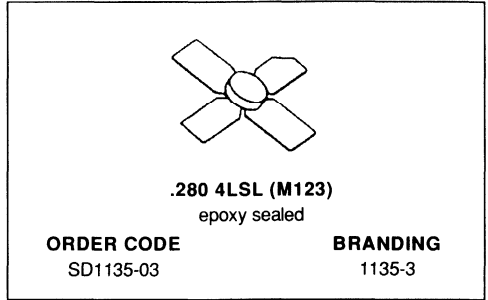
Ref.: Dwg. No.12-0122



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51

## RF & MICROWAVE TRANSISTORS VHF PORTABLE/MOBILE APPLICATIONS

- 150 MHz
- 7.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 2.5 \text{ W MIN. WITH } 11.0 \text{ dB GAIN}$



### DESCRIPTION

The SD1135-03 is a 7.5 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. It withstands severe mismatch under operating conditions.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CER}$	Collector-Emitter Voltage	16	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	1.7	A
$P_{DISS}$	Power Dissipation	15	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	11.6	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

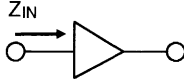
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 10mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	16	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CER}$	$V_{CE} = 10V$	$R_{BE} = 50\Omega$	—	—	0.5	mA
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 200mA$	20	—	—	—

DYNAMIC

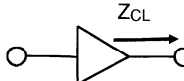
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{OUT}$	$f = 150\text{ MHz}$	$V_{CC} = 7.5\text{ V}$	2.5	—	—	W
$G_P$	$f = 150\text{ MHz}$	$V_{CC} = 7.5\text{ V}$	11.0	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 7.5\text{ V}$	—	19	—	pF

IMPEDANCE DATA

**TYPICAL INPUT IMPEDANCE**



**TYPICAL COLLECTOR LOAD IMPEDANCE**



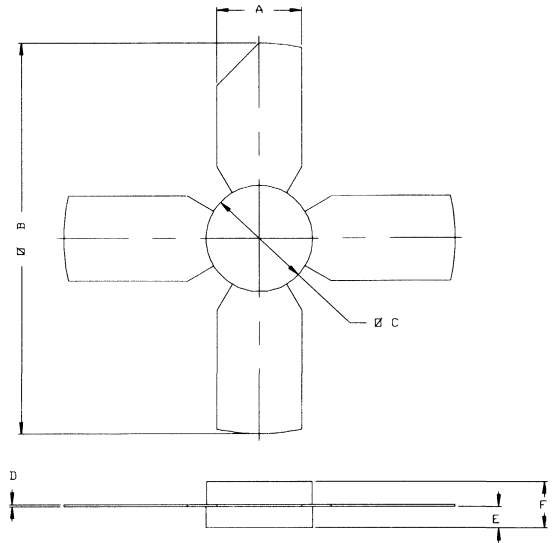
FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
150 MHz	$2.2 - j 0.4$	$7.9 + j 8.4$
160 MHz	$1.9 - j 0.8$	$7.6 + j 8.2$
170 MHz	$1.0 - j 1.0$	$6.0 + j 8.3$

$P_{OUT} = 2.5W$   
 $V_{CE} = 7.5V$

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0123

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	-----	1.055/26,8
C	.275/6,99	.285/7,24
D	.004/0,10	.006/0,15
E	.050/1,27	.060/1,52
F	.118/3,00	.130/3,30

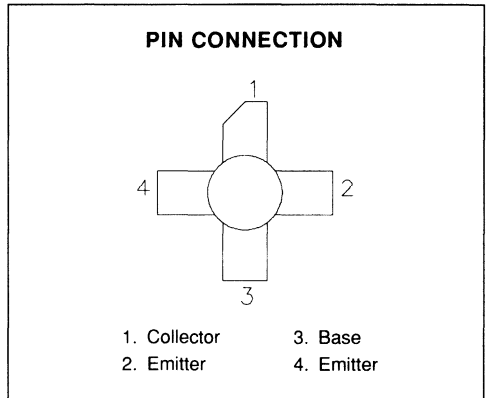
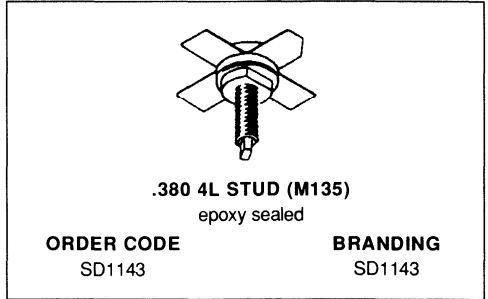






**RF & MICROWAVE TRANSISTORS  
VHF MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 10 \text{ W MIN. WITH } 10 \text{ dB GAIN}$


**DESCRIPTION**

The SD1143 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. It withstands very high VSWR under operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	20	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	8.75	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 15mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 2.5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	5	—	200	—

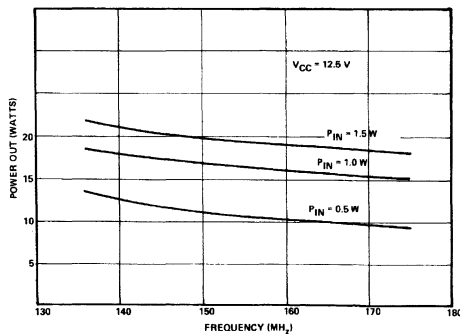
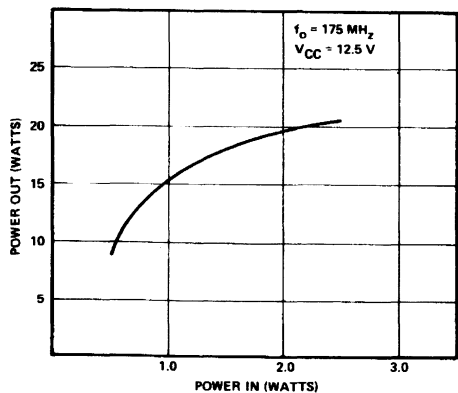
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175\text{ MHz}$	$P_{IN} = 1\text{ W}$	$V_{CC} = 12.5\text{ V}$	10	—	—	W
$G_P$	$f = 175\text{ MHz}$	$P_{IN} = 1\text{ W}$	$V_{CC} = 12.5\text{ V}$	10	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 15\text{ V}$		—	—	45	pF

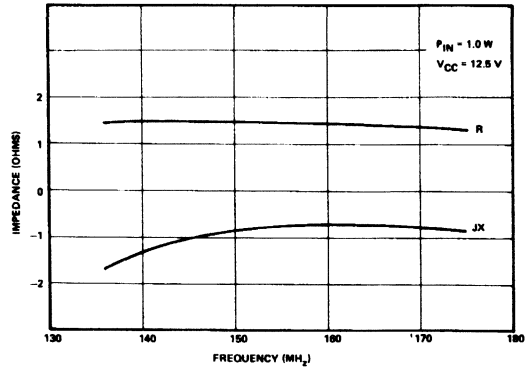
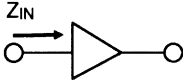
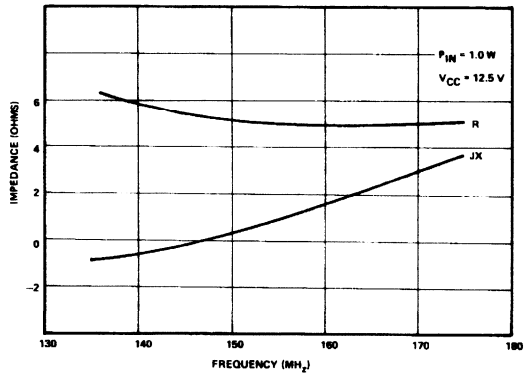
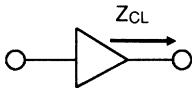
TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

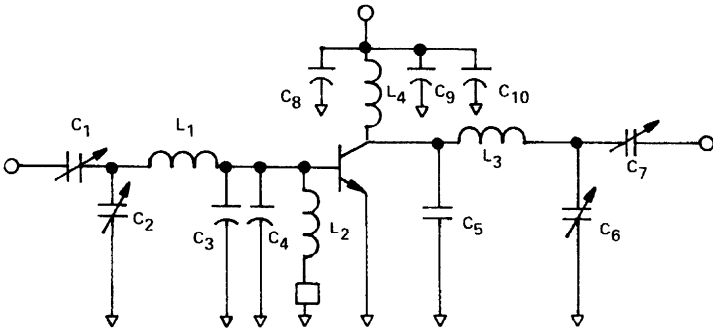
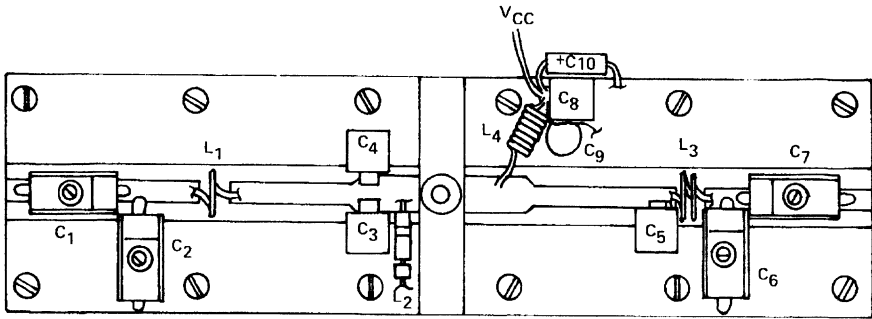
POWER OUTPUT vs FREQUENCY



## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

TEST CIRCUIT

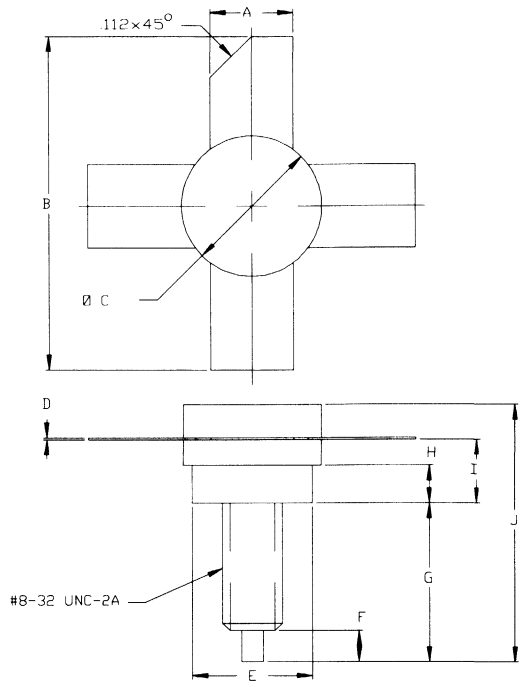


- |       |                  |     |   |
|-------|------------------|-----|---|
| C1    | : ARCO 423       | C9  | : 0.001 $\mu$ F Disc                          |
| C2,C6 | : ARCO 422       | C10 | : 5.6 $\mu$ F Tantalum                        |
| C3    | : 82pF, Unelco   | L1  | : 1 Turn, #16 AWG 3/8" Diameter               |
| C4    | : 120 pF, Unelco | L2  | : 33 $\mu$ H Molded Choke                     |
| C5    | : 56pF, Unelco   | L3  | : 2 Turns, #16 AWG 1/4" Diameter              |
| C7    | : ARCO 425       | L4  | : 10 Turns, #22 AWG 1/8" Diameter Close Wound |
| C8    | : 1000pF, Unelco |     |   |

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0135

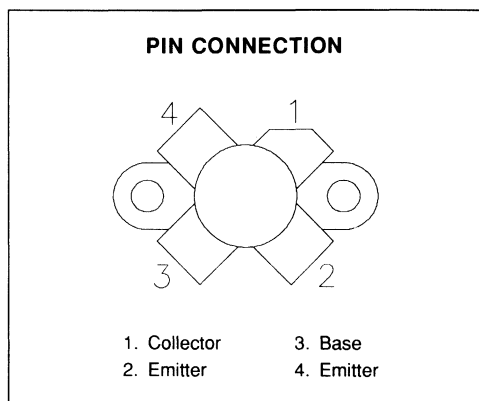
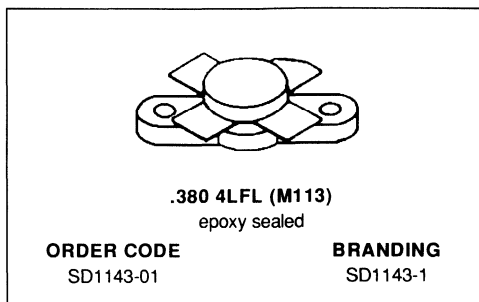
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05





**RF & MICROWAVE TRANSISTORS  
 VHF MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 10 \text{ W MIN. WITH } 10 \text{ dB GAIN}$


**DESCRIPTION**

The SD1143-01 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. It withstands very high VSWR under operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CER}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	20	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	8.75	$^{\circ}\text{C}/\text{W}$
---------------	----------------------------------	------	-----------------------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

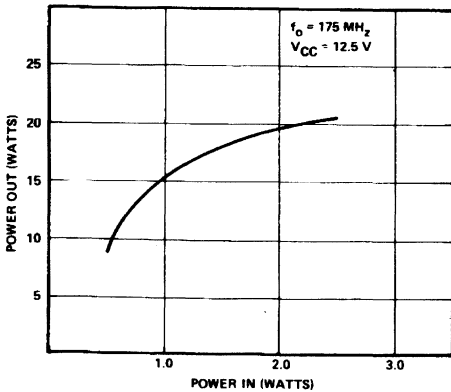
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 50mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 15mA	I <sub>B</sub> = 0mA	18	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 2.5mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 15V	I <sub>E</sub> = 0mA	—	—	2	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 250mA	5	—	200	—

DYNAMIC

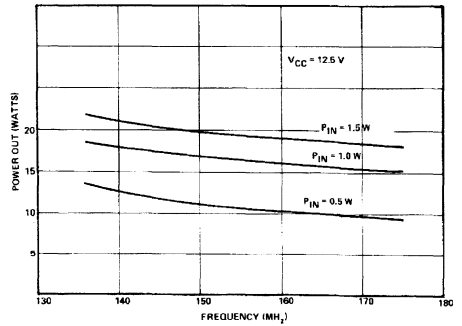
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 175 MHz	P <sub>IN</sub> = 1 W	V <sub>CC</sub> = 12.5 V	10	—	—	W
G <sub>P</sub>	f = 175 MHz	P <sub>IN</sub> = 1 W	V <sub>CC</sub> = 12.5 V	10	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 15 V		—	—	45	pF

TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT



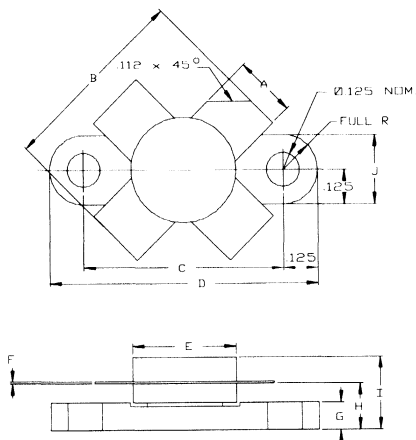
POWER OUTPUT vs FREQUENCY





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0113

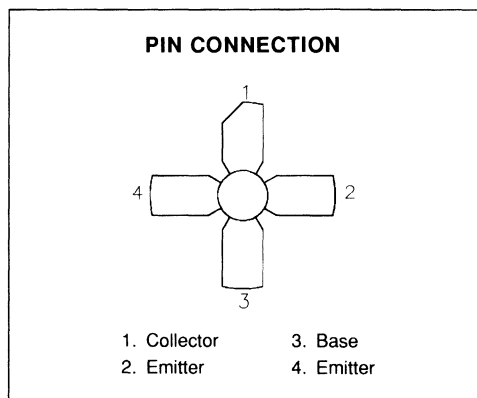
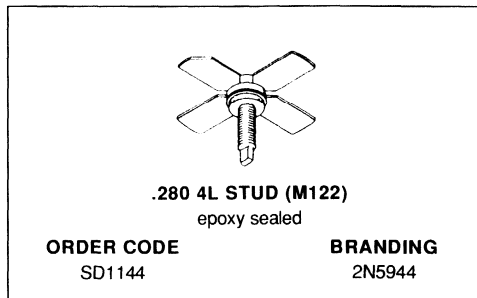


SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5.59	.230/5.84
B	.785/19.94	
C	.720/18.29	.730/18.54
D	.970/24.64	.980/24.89
E		.385/9.78
F	.004/0.10	.006/0.15
G	.085/2.16	.105/2.67
H	.160/4.06	.180/4.57
I		.280/7.11
J	.240/6.10	.255/6.48



**RF & MICROWAVE TRANSISTORS  
 UHF MOBILE APPLICATIONS**

- 470 MHz
- 12.5 VOLTS
- COMMON EMITTER
- COLLECTOR EFFICIENCY 60%
- P<sub>OUT</sub> = 2 W MIN. WITH 9 dB GAIN


**DESCRIPTION**

The SD1144 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for UHF communications. This device utilizes improved metallization to achieve infinite VSWR at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	36	V
V <sub>CEO</sub>	Collector-Emitter Voltage	16	V
V <sub>CES</sub>	Collector-Emitter Voltage	36	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	0.4	A
P <sub>DISS</sub>	Power Dissipation	5.0	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	35	°C/W
----------------------	----------------------------------	----	------

# SD1144 (2N5944)

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

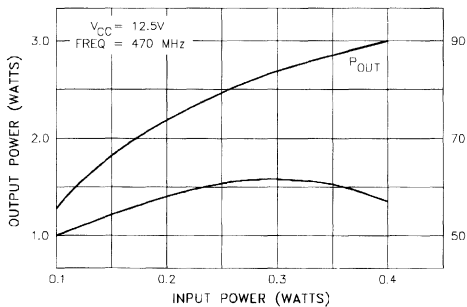
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 50mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 50mA	I <sub>B</sub> = 0mA	16	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 15V	I <sub>E</sub> = 0mA	—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 100mA	20	—	—	—

### DYNAMIC

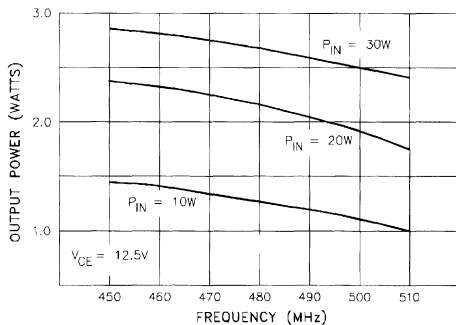
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 470 MHz	P <sub>IN</sub> = 0.25 W	V <sub>CE</sub> = 12.5 V	2	—	—	W
G <sub>P</sub>	f = 470 MHz	P <sub>IN</sub> = 0.25 W	V <sub>CE</sub> = 12.5 V	9	—	—	dB
η <sub>C</sub>	f = 470 MHz	P <sub>IN</sub> = 0.25 W	V <sub>CE</sub> = 12.5 V	60	—	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12.5 V		—	—	15	pF

### TYPICAL PERFORMANCE

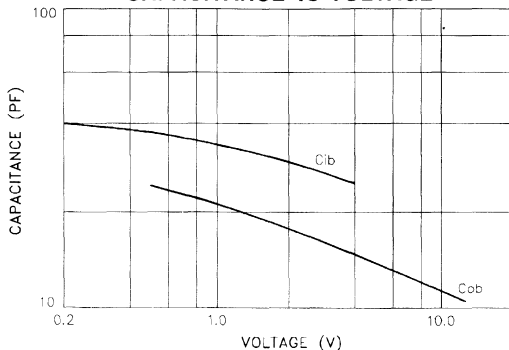
**POWER OUTPUT vs POWER INPUT**



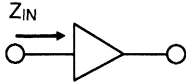
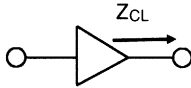
**POWER OUTPUT vs FREQUENCY**



**CAPACITANCE vs VOLTAGE**

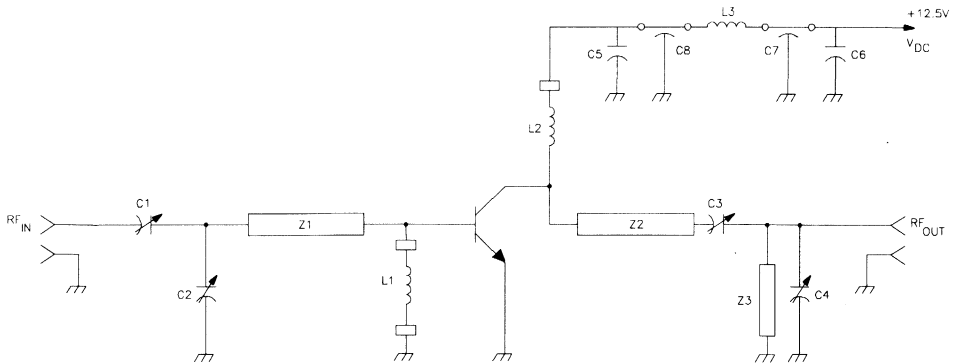


## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>OUT</sub> (Ω)
470 MHz	2.24 + j 6.5	13.0 - j 8.65

## TEST CIRCUIT



C1, C2 :  
C3, C4 : 1.0 - 25pF, Arco 421  
C5 : 1.0μF, 35V, Electrolytic  
C6 : 4.7μF, 35V, Electrolytic  
C7, C8 : 1000pF Feedthru

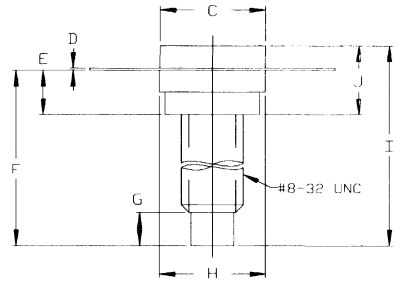
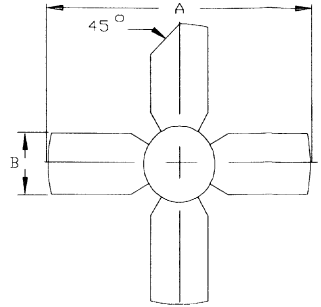
L1, L2 : 7 Turns #22 Enameled 0.175" I.D. with Ferroxcube  
Ferrite Beads #56-590-65/3B  
L3 : 2 Turns in Ferroxcube VK200/10-3B (RFC)

Board Material: Glass Teflon, 1/16" Duriod

PACKAGE MECHANICAL DATA

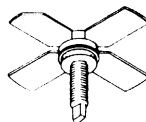
Ref.: Dwg. No.12-0122

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51



**RF & MICROWAVE TRANSISTORS  
 UHF MOBILE APPLICATIONS**

- 470 MHz
- 12.5 VOLTS
- EFFICIENCY 60%
- COMMON EMITTER
- $P_{OUT} = 10.0 \text{ W MIN. WITH } 6.0 \text{ dB GAIN}$



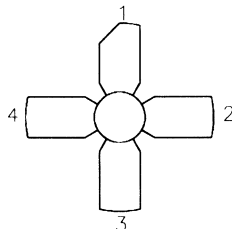
**.280 4L STUD (M122)**  
 epoxy sealed

**ORDER CODE**  
 SD1146

**BRANDING**  
 2N5946

**DESCRIPTION**

The SD1146 is a Class C 12.5 V epitaxial silicon NPN planar transistor designed primarily for UHF communications. This device utilizes improved metallization to achieve infinite VSWR at rated operating conditions.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36.0	V
$V_{CEO}$	Collector-Emitter Voltage	16.0	V
$V_{CES}$	Collector-Emitter Voltage	36.0	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation (+25°C)	37.5	W
$T_J$	Junction Temperature	+200	°C
$T_{STG}$	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	4.7	°C/W
---------------	----------------------------------	-----	------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

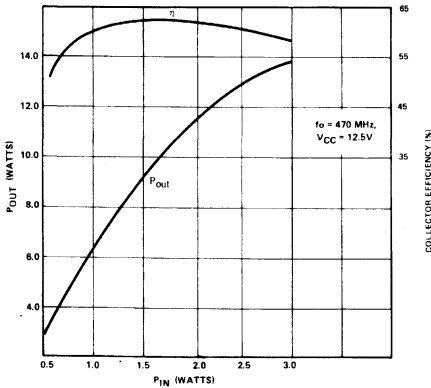
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 200mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 200mA		16	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 4mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CBO</sub>	V <sub>CE</sub> = 15V	I <sub>E</sub> = 0mA	—	—	2	mA
I <sub>CES</sub>	V <sub>CE</sub> = 15V	I <sub>C</sub> = 0mA	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = .5A	20	—	—	—

DYNAMIC

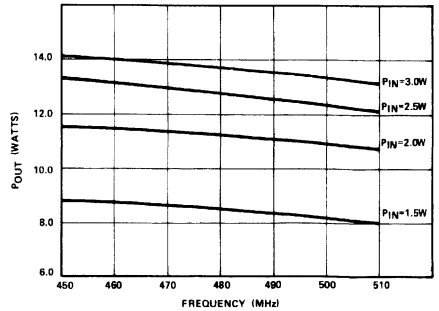
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 470 MHz	P <sub>IN</sub> = 2.5 W	V <sub>CC</sub> = 12.5 V	10	—	—	W
η <sub>c</sub>	f = 470 MHz	P <sub>IN</sub> = 2.5 W	V <sub>CC</sub> = 12.5 V	60	—	—	%
G <sub>P</sub>	f = 470 MHz	P <sub>IN</sub> = 2.5 W	V <sub>CC</sub> = 12.5 V	6	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12.5 V		—	—	45	pF

TYPICAL PERFORMANCE

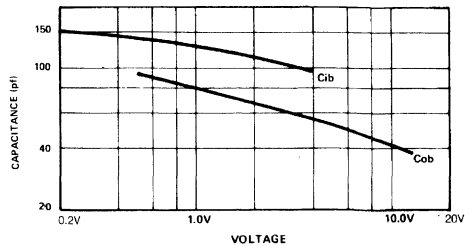
POWER OUTPUT vs POWER INPUT



POWER OUTPUT vs FREQUENCY

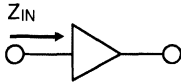
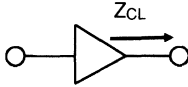


CAPACITANCE vs VOLTAGE





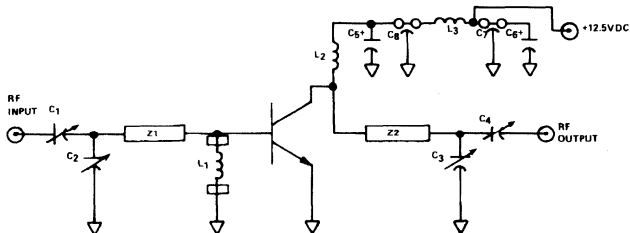
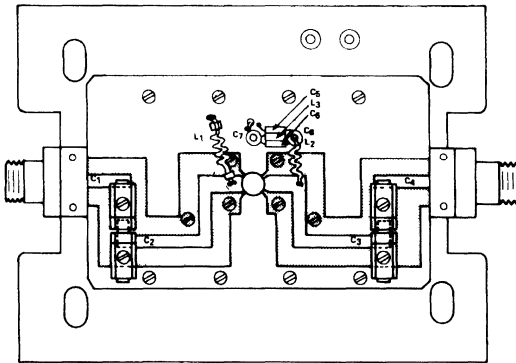
## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
470 MHz	1.6 + j 2.2	6.0 - j 0.34

P<sub>OUT</sub> = 10.0 W  
V<sub>CC</sub> = 12.5 V

## TEST CIRCUIT



- C1 : 1.0-20pF, ARCO #420  
 C2,C3,C4 : 1.0-25pF, ARCO #421  
 C5,C6 : Electrolytic, 1.0μF, 35V  
 C7,C8 : Feedthru, 1000pF  
 L1 : 7 Turns #22 Enameled 0.175" I.D. Ferroxcube  
 Ferrite Beads #56-590-65/3B

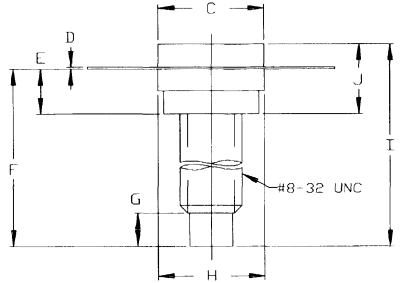
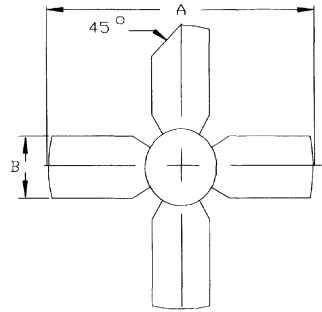
- L2 : 5 Turns #22 Enameled 0.175" I.D.  
 L3 : 2 Turns in Ferroxcube VK 200/19-4B (RFC)

Board Material - Glass Teflon 1/16" Duroid

PACKAGE MECHANICAL DATA

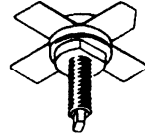
Ref.: Dwg. No.12-0122

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51



**RF & MICROWAVE TRANSISTORS  
 VHF FM APPLICATIONS**

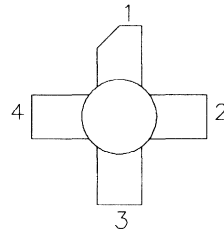
- 175 MHz
- 28 VOLTS
- CLASS C
- COMMON EMITTER
- EFFICIENCY 60% MIN
- P<sub>OUT</sub> = 40 W MIN. WITH 7.6 dB GAIN



**.380 4L STUD (M135)**  
 epoxy sealed

**ORDER CODE**  
 SD1224

**BRANDING**  
 2N5643

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

**DESCRIPTION**

The SD1224 is an epitaxial silicon NPN planar transistor designed primarily for 28 V FM Class C RF amplifiers utilized in ground station transmitters. This device utilizes ballasted emitter resistors and improved metallization systems to achieve optimum load mismatch capability.

**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	65	V
V <sub>CEO</sub>	Collector-Emitter Voltage	35	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	5.0	A
P <sub>DISS</sub>	Power Dissipation	60	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	2.9	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

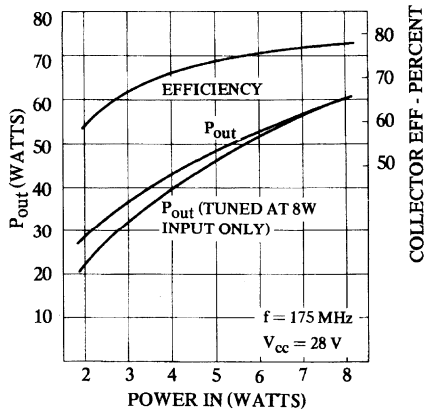
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_B = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 200mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{CEO}$	$I_C = 200mA$	$I_B = 0mA$	35	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 30V$	$I_E = 0mA$	—	—	10	mA
$I_{CBO}$	$V_{CB} = 30V$	$I_E = 0mA$	—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	5	—	200	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175\text{ MHz}$	$P_{IN} = 7.0\text{ W}$	$V_{CE} = 28\text{ V}$	40	—	—	W
$G_P$	$f = 175\text{ MHz}$	$P_{IN} = 7.0\text{ W}$	$V_{CE} = 28\text{ V}$	7.6	—	—	dB
$\eta_c$	$f = 175\text{ MHz}$	$P_{IN} = 7.0\text{ W}$	$V_{CE} = 28\text{ V}$	60	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 30\text{ V}$		—	—	65	pF

TYPICAL PERFORMANCE

**POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT**



Power Output vs Power Input

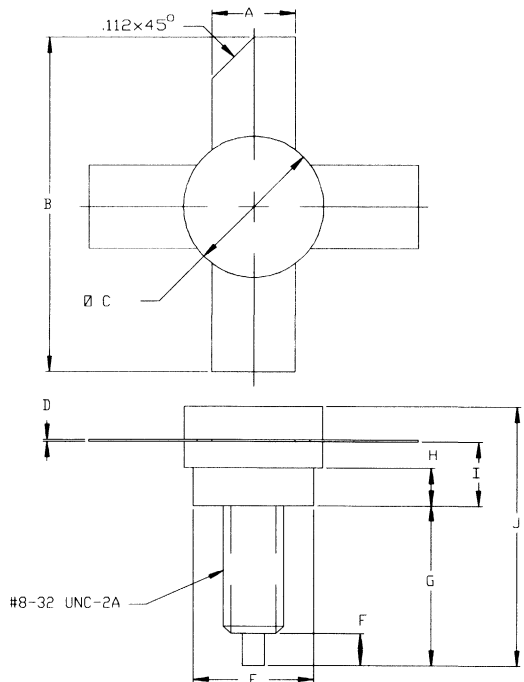
## IMPEDANCE DATA

P <sub>IN</sub> (W)	P <sub>OUT</sub> (W)	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
2.0	28.5	0.85 + j 1.20	3.25 + j 7.05
4.0	43.0	1.02 + j 1.32	4.45 + j 5.40
6.0	53.0	1.01 + j 1.42	5.25 + j 4.42
8.0	60.5	1.05 + j 1.35	5.45 + j 4.12

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0135

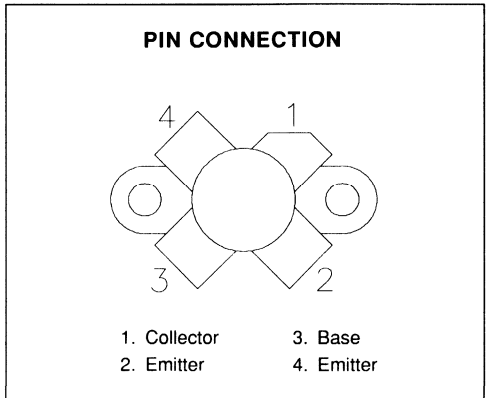
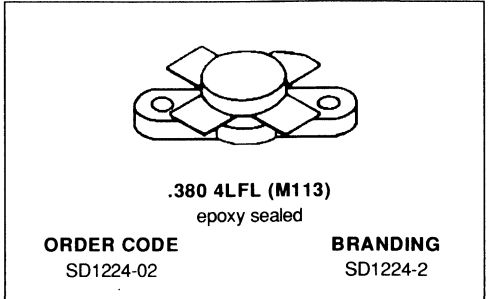
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05





**RF & MICROWAVE TRANSISTORS  
 VHF APPLICATIONS**

- 175 MHz
- 28 VOLTS
- EFFICIENCY 60%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 40 \text{ W MIN. WITH } 7.6 \text{ dB GAIN}$


**DESCRIPTION**

The SD1224-02 is an epitaxial silicon NPN planar transistor designed primarily for 12.5 V AM Class C RF amplifiers functional in the aviation band 118 - 136 MHz and for 28 V FM Class C RF amplifiers utilized in ground station transmitters. It withstands extremely high VSWR under operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	35	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	5.0	A
$P_{DISS}$	Power Dissipation	60	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.9	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

# SD1224-02

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

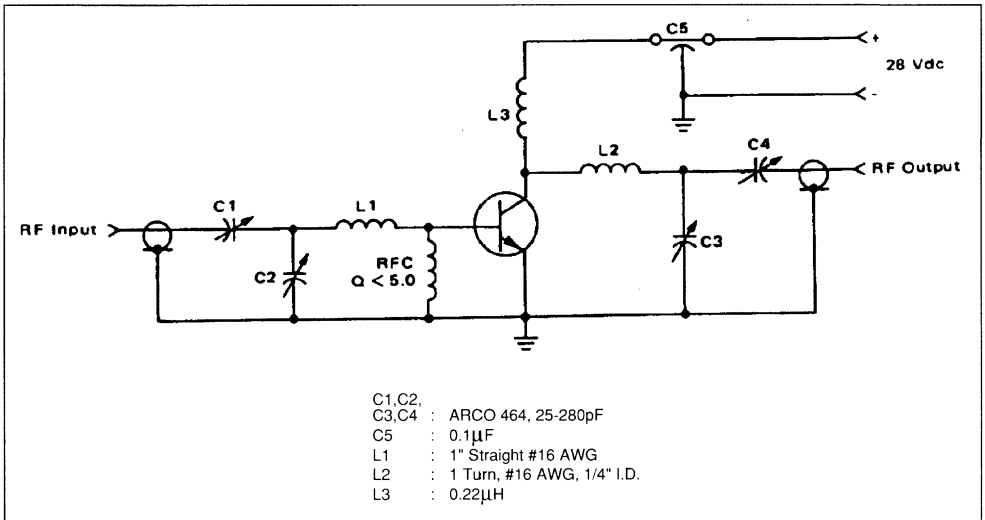
### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 200mA	V <sub>BE</sub> = 0V	65	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 200mA	V <sub>BE</sub> = 0V	65	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 200mA	I <sub>B</sub> = 0mA	35	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 30V	I <sub>E</sub> = 0mA	—	—	1	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500mA	5	—	—	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 175 MHz	P <sub>IN</sub> = 7 W	V <sub>CC</sub> = 28 V	40	—	—	W
η <sub>c</sub>	f = 175 MHz	P <sub>IN</sub> = 7 W	V <sub>CC</sub> = 28 V	60	—	—	%
G <sub>P</sub>	f = 175 MHz	P <sub>IN</sub> = 7 W	V <sub>CC</sub> = 28 V	7.6	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 30 V		—	—	65	pF

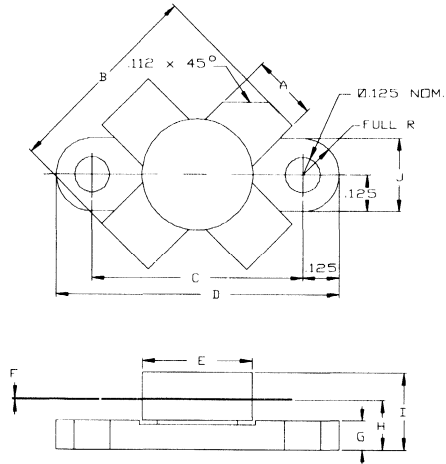
### TEST CIRCUIT





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0113

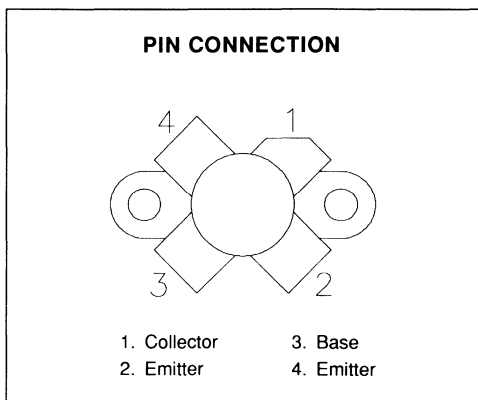
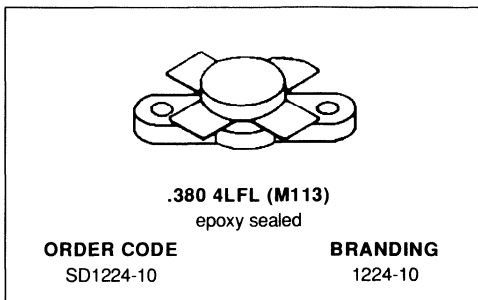


SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.385/9,78
F	.004/0,10	.006/0,15
G	.085/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48



## RF & MICROWAVE TRANSISTORS HF SSB APPLICATIONS

- 30 MHz
- 28 VOLTS
- IMD -28 dB
- COMMON EMITTER
- GOLD METALLIZATION
- P<sub>OUT</sub> = 30 W MIN. WITH 18 dB GAIN



### DESCRIPTION

The SD1224-10 is a 28 V epitaxial silicon NPN planar transistor designed primarily for SSB communications. This device utilizes emitter ballasting for improved ruggedness and reliability.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	65	V
V <sub>CEO</sub>	Collector-Emitter Voltage	36	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	4.5	A
P <sub>DISS</sub>	Power Dissipation	80	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	2.2	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 200\text{mA}$	$I_{\text{E}} = 0\text{mA}$		65	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 200\text{mA}$	$V_{\text{BE}} = 0\text{V}$		65	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 200\text{mA}$	$I_{\text{B}} = 0\text{mA}$		35	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$		4.0	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$		—	—	1	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = .5\text{A}$		5	—	200	—

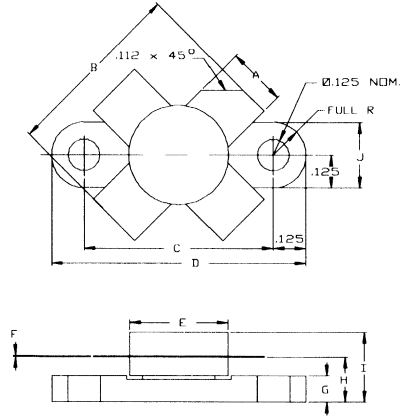
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 30\text{ MHz}$	$V_{\text{CE}} = 28\text{ V}$	$I_{\text{CQ}} = 25\text{ mA}$	30	—	—	W
$G_{\text{P}}$	$f = 30\text{ MHz}$	$V_{\text{CE}} = 28\text{ V}$	$I_{\text{CQ}} = 25\text{ mA}$	18	20	—	dB
IMD	$f = 30\text{ MHz}$	$V_{\text{CE}} = 28\text{ V}$	$I_{\text{CQ}} = 25\text{ mA}$	—	-32	-28	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 30\text{ V}$		—	—	65	pF

Note:  $P_{\text{IN}} = 0.48\text{W}$

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0

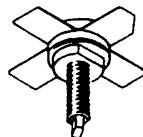


SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.385/9,78
F	.004/0,10	.006/0,15
G	.085/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48



**RF & MICROWAVE TRANSISTORS  
 VHF MOBILE APPLICATIONS**

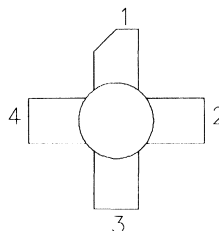
- 160 MHz
- 13.6 VOLTS
- COMMON EMITTER
- $P_{OUT} = 40$  W MIN. WITH 9.0 dB GAIN



**.380 4L STUD (M135)**  
 epoxy sealed

**ORDER CODE**  
 SD1273

**BRANDING**  
 SD1273

**PIN CONNECTION**


1. Collector                      3. Base  
 2. Emitter                        4. Emitter

**DESCRIPTION**

The SD1273 is especially designed for VHF large signal amplifier applications in industrial and commercial FM equipment operating up to 175 MHz. Ideally suited for marine radio applications.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	5.0	A
$P_{DISS}$	Power Dissipation	70	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.5	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{E}} = 0\text{mA}$	36	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 50\text{mA}$	$V_{\text{BE}} = 0\text{mA}$	36	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$	18	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CES}}$	$V_{\text{CE}} = 15\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 5\text{A}$	20	—	200	—

## DYNAMIC

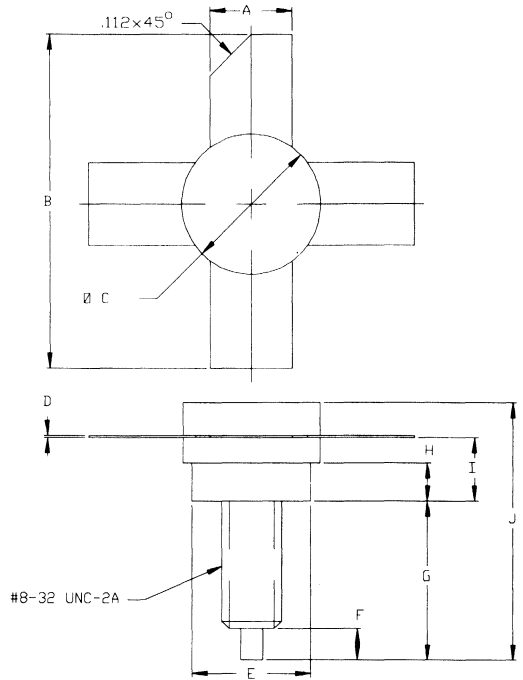
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 160\text{ MHz}$	$P_{\text{IN}} = 5\text{ W}$	$V_{\text{CC}} = 13.6\text{ V}$	40	—	—	W
$G_{\text{P}}$	$f = 160\text{ MHz}$	$P_{\text{IN}} = 5\text{ W}$	$V_{\text{CC}} = 13.6\text{ V}$	9	—	—	dB
$\eta_{\text{C}}$	$f = 160\text{ MHz}$	$P_{\text{IN}} = 5\text{ W}$	$V_{\text{CC}} = 13.6\text{ V}$	55	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 13.6\text{ V}$		—	—	135	pF



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0135

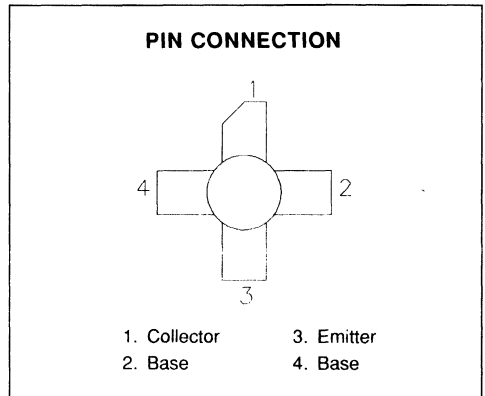
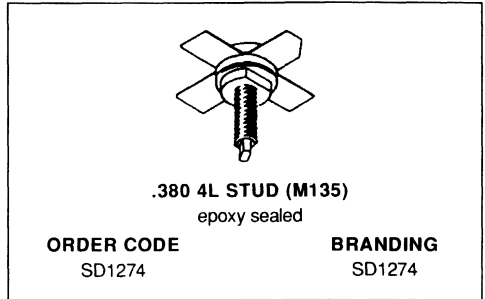
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05





**RF & MICROWAVE TRANSISTORS  
VHF MOBILE APPLICATIONS**

- 160 MHz
- 13.6 VOLTS
- COMMON EMITTER
- P<sub>OUT</sub> = 30 W MIN. WITH 10 dB GAIN


**DESCRIPTION**

The SD1274 is a 13.6 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. The SD1274 utilizes an emitter ballasted die geometry to withstand severe load mismatch conditions.

**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	36	V
V <sub>CEO</sub>	Collector-Emitter Voltage	18	V
V <sub>CES</sub>	Collector-Emitter Voltage	36	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>c</sub>	Device Current	8.0	A
P <sub>DISS</sub>	Power Dissipation	70	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	1.2	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 15mA$	$V_{BE} = 0mA$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	20	—	—	—

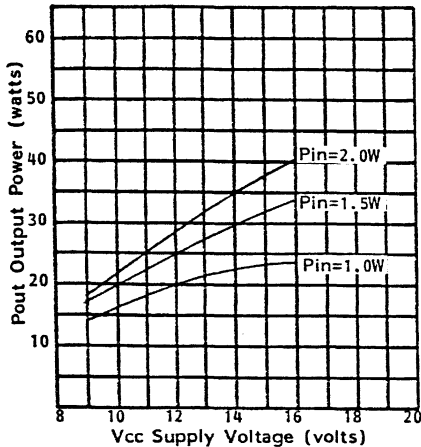
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 160\text{ MHz}$	$P_{IN} = 3.0\text{ W}$	$V_{CE} = 13.6\text{ V}$	30	—	—	W
$G_P$	$f = 160\text{ MHz}$	$P_{IN} = 3.0\text{ W}$	$V_{CE} = 13.6\text{ V}$	10	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 15\text{ V}$		—	95	—	pF

TYPICAL PERFORMANCE

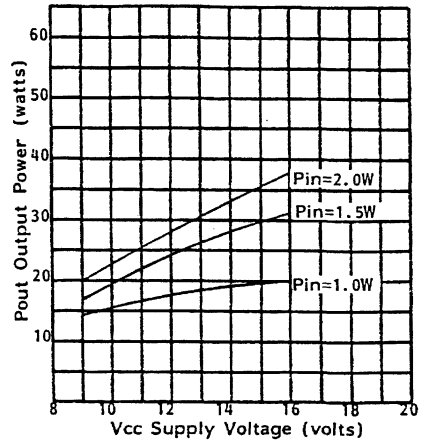
**POWER OUTPUT vs SUPPLY VOLTAGE**  
(136 MHz)

Output Power vs Supply Voltage  
 $F = 136\text{ MHz}$

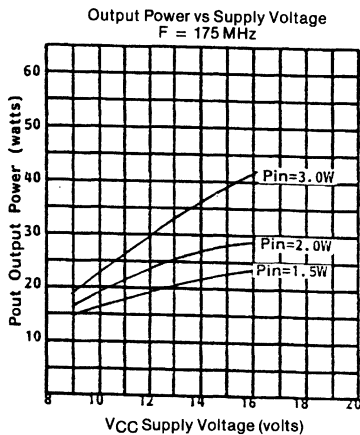


**POWER OUTPUT vs SUPPLY VOLTAGE**  
(150 MHz)

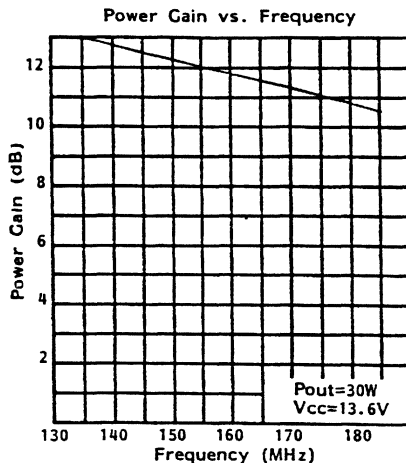
Output Power vs Supply Voltage  
 $F = 150\text{ MHz}$



## TYPICAL PERFORMANCE (cont'd)

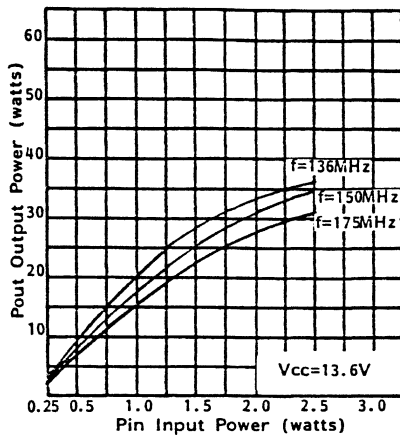
POWER OUTPUT vs SUPPLY VOLTAGE  
(175 MHz)

## POWER GAIN vs FREQUENCY



## POWER OUTPUT vs POWER INPUT

Output Power vs. Input Power



## IMPEDANCE DATA

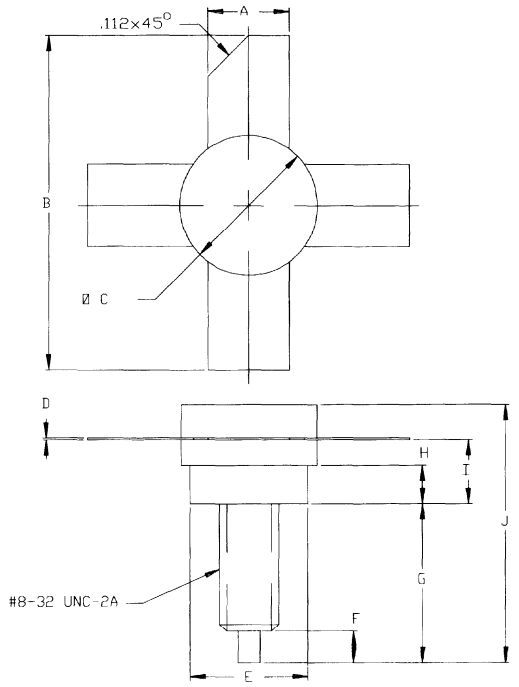
FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
175 MHz	1.0 + j 0.4	2.3 + j 0.1

P<sub>IN</sub> = 3.0 WV<sub>CE</sub> = 12.5 V

PACKAGE MECHANICAL DATA

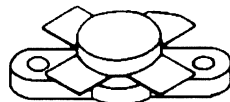
Ref.: Dwg. No.12-0135

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05



**RF & MICROWAVE TRANSISTORS  
 VHF MOBILE APPLICATIONS**

- 160 MHz
- 13.6 VOLTS
- COMMON EMITTER
- $P_{OUT} = 30 \text{ W MIN. WITH } 10 \text{ dB GAIN}$


**.380 4LFL (M113)**

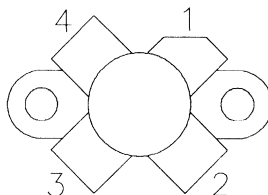
epoxy sealed

**ORDER CODE**

SD1274-01

**BRANDING**

SD1274-1

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

**DESCRIPTION**

The SD1274-01 is a 13.6 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. The SD1274-01 utilizes an emitter ballasted die geometry to withstand severe load mismatch conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	8.0	A
$P_{DISS}$	Power Dissipation	70	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.2	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 15mA$	$V_{BE} = 0mA$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	20	—	—	—

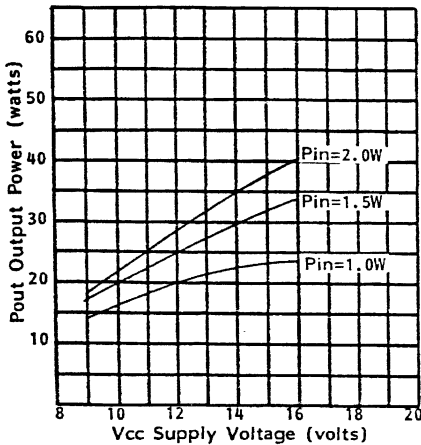
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 160\text{ MHz}$	$P_{IN} = 3.0\text{ W}$	$V_{CE} = 13.6\text{ V}$	30	—	—	W
$G_P$	$f = 160\text{ MHz}$	$P_{IN} = 3.0\text{ W}$	$V_{CE} = 13.6\text{ V}$	10	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 15\text{ V}$		—	95	—	pF

**TYPICAL PERFORMANCE**

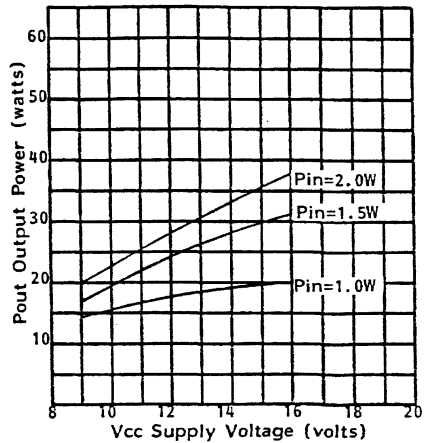
**POWER OUTPUT vs SUPPLY VOLTAGE**  
(136 MHz)

Output Power vs Supply Voltage  
 $F = 136\text{ MHz}$



**POWER OUTPUT vs SUPPLY VOLTAGE**  
(150 MHz)

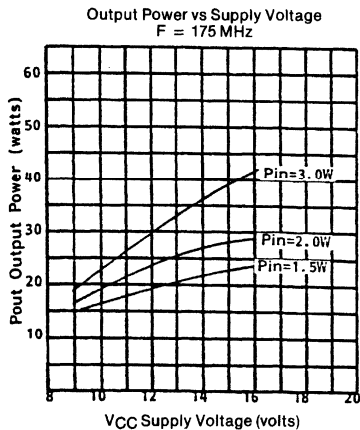
Output Power vs Supply Voltage  
 $F = 150\text{ MHz}$



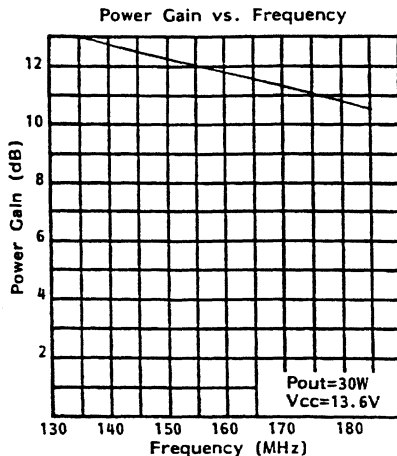


TYPICAL PERFORMANCE (cont'd)

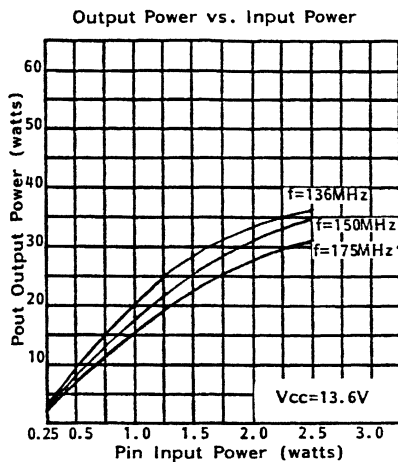
**POWER OUTPUT vs SUPPLY VOLTAGE**  
(175 MHz)



**POWER GAIN vs FREQUENCY**



**POWER OUTPUT vs POWER INPUT**



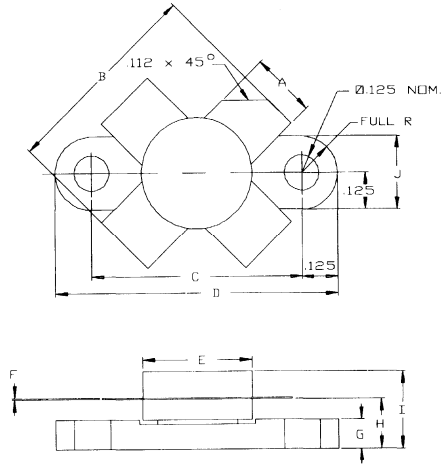
IMPEDANCE DATA

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
175 MHz	1.0 + j 0.4	2.3 + j 0.1

P<sub>IN</sub> = 3.0 W  
V<sub>CE</sub> = 12.5 V

PACKAGE MECHANICAL DATA

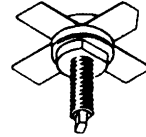
Ref.: Dwg. No.12-0113



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.385/9,78
F	.004/0,10	.006/0,15
G	.085/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48

**RF & MICROWAVE TRANSISTORS  
 VHF MOBILE APPLICATIONS**

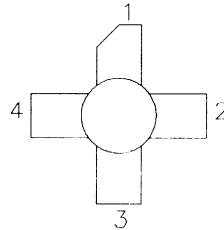
- 160 MHz
- 13.6 VOLTS
- COMMON EMITTER
- $P_{OUT} = 40 \text{ W MIN. WITH } 9.0 \text{ dB GAIN}$



**.380 4L STUD (M135)**  
 epoxy sealed

**ORDER CODE**  
 SD1275

**BRANDING**  
 SD1275

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**DESCRIPTION**

The SD1275 is a 13.6 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. The SD1275 utilizes an emitter ballasted die geometry to withstand severe load mismatch conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	8.0	A
$P_{DISS}$	Power Dissipation	70	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.2	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

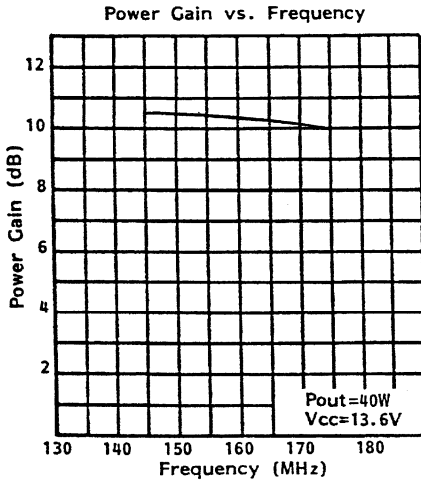
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 15mA	V <sub>BE</sub> = 0mA	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 50mA	I <sub>B</sub> = 0mA	18	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 15V	I <sub>E</sub> = 0mA	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 250mA	20	—	—	—

DYNAMIC

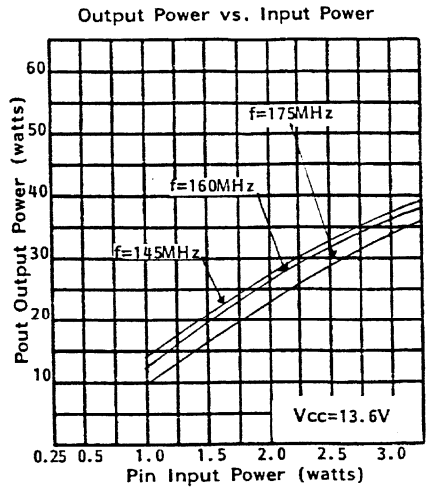
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 160 MHz	P <sub>IN</sub> = 5.0 W	V <sub>CE</sub> = 13.6 V	40	—	—	W
G <sub>P</sub>	f = 160 MHz	P <sub>IN</sub> = 5.0 W	V <sub>CE</sub> = 13.6 V	9	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 15 V		—	95	—	pF

TYPICAL PERFORMANCE

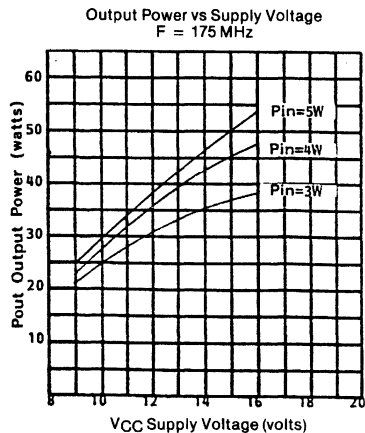
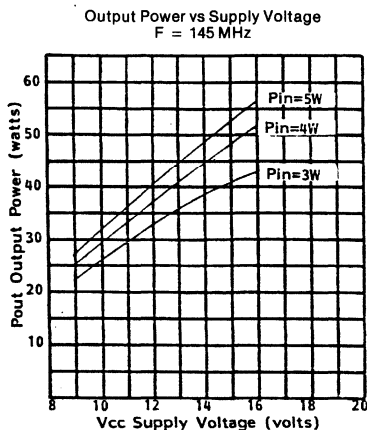
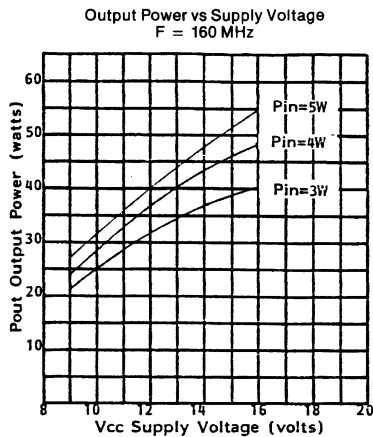
POWER GAIN vs FREQUENCY



POWER OUTPUT vs POWER INPUT



## TYPICAL PERFORMANCE (cont'd)

POWER OUTPUT vs SUPPLY VOLTAGE  
(175 MHz)POWER OUTPUT vs SUPPLY VOLTAGE  
(145 MHz)POWER OUTPUT vs SUPPLY VOLTAGE  
(160 MHz)

## IMPEDANCE DATA

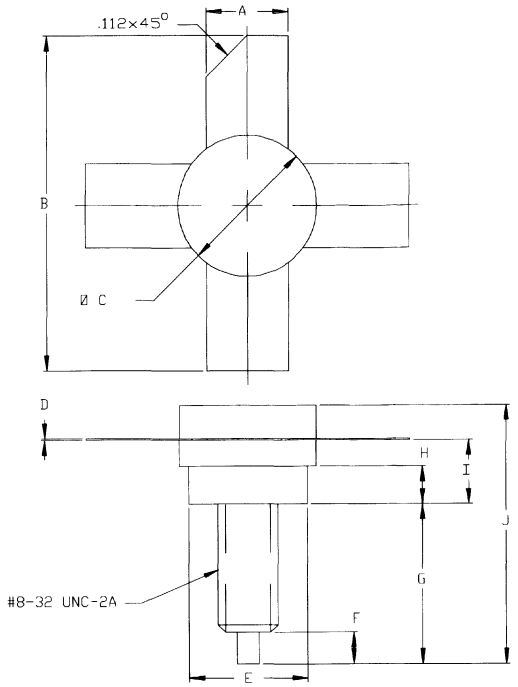
FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
160 MHz	1.0 + j 0.4	2.3 + j 0.1

P<sub>IN</sub> = 3.0 WV<sub>CE</sub> = 12.5 V

PACKAGE MECHANICAL DATA

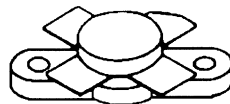
Ref.: Dwg. No.12-0135

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05



**RF & MICROWAVE TRANSISTORS  
 VHF MOBILE APPLICATIONS**

- 160 MHz
- 13.6 VOLTS
- COMMON EMITTER
- $P_{OUT} = 40$  W MIN. WITH 9.0 dB GAIN


**.380 4LFL (M113)**

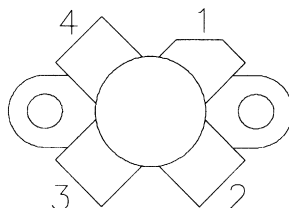
epoxy sealed

**ORDER CODE**

SD1275-01

**BRANDING**

SD1275-1

**PIN CONNECTION**


1. Collector

2. Emitter

3. Base

4. Emitter

**DESCRIPTION**

The SD1275-01 is a 13.6 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. The SD1275-01 utilizes an emitter ballasted die geometry to withstand severe load mismatch conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	8.0	A
$P_{DISS}$	Power Dissipation	70	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.2	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

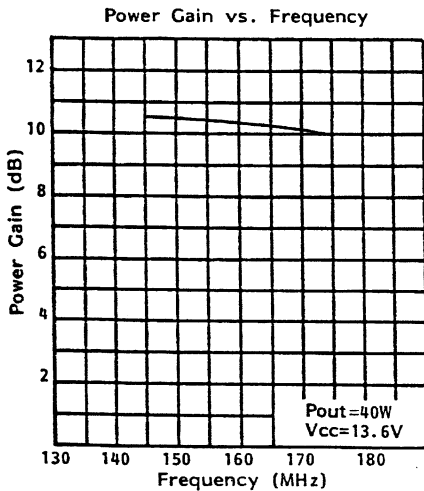
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 15mA$	$V_{BE} = 0mA$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	20	—	—	—

DYNAMIC

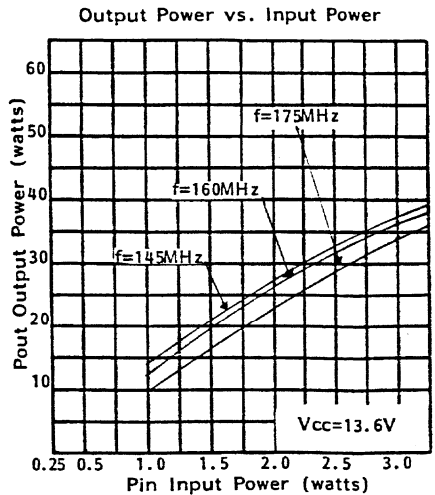
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 160\text{ MHz}$	$P_{IN} = 5.0\text{ W}$	$V_{CE} = 13.6\text{ V}$	40	—	—	W
$G_P$	$f = 160\text{ MHz}$	$P_{IN} = 5.0\text{ W}$	$V_{CE} = 13.6\text{ V}$	9	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 15\text{ V}$		—	95	—	pF

TYPICAL PERFORMANCE

**POWER GAIN vs FREQUENCY**

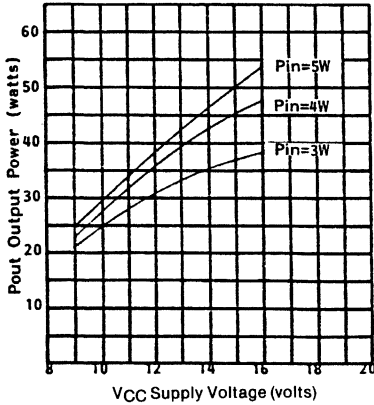
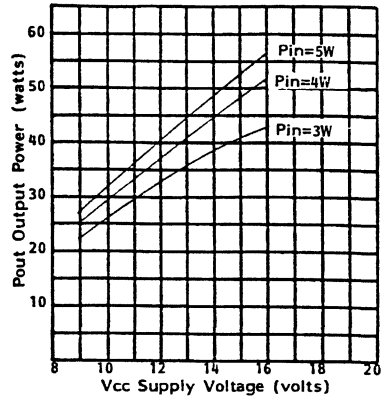
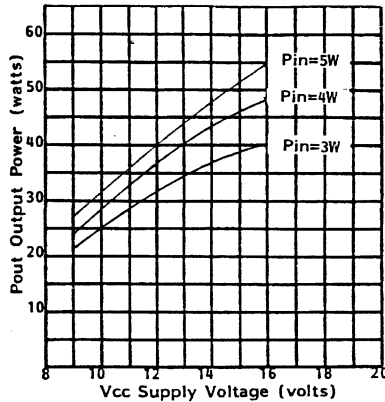


**POWER OUTPUT vs POWER INPUT**





## TYPICAL PERFORMANCE (cont'd)

POWER OUTPUT vs SUPPLY VOLTAGE  
(175 MHz)Output Power vs Supply Voltage  
F = 175 MHzPOWER OUTPUT vs SUPPLY VOLTAGE  
(145 MHz)Output Power vs Supply Voltage  
F = 145 MHzPOWER OUTPUT vs SUPPLY VOLTAGE  
(160 MHz)Output Power vs Supply Voltage  
F = 160 MHz

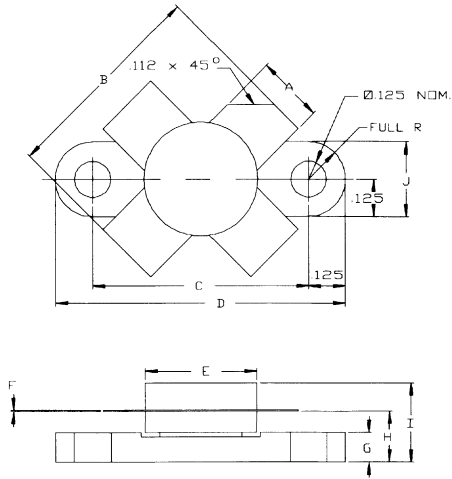
## IMPEDANCE DATA

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
160 MHz	1.0 + j 0.4	2.3 + j 0.1

P<sub>IN</sub> = 3.0 WV<sub>CE</sub> = 12.5 V

PACKAGE MECHANICAL DATA

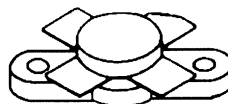
Ref.: Dwg. No.12-0113



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.385/9,78
F	.004/0,10	.006/0,15
G	.085/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48

**RF & MICROWAVE TRANSISTORS**  
**HF SSB APPLICATIONS**

- 30 MHz
- 12.5 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- IMD – 30 dB
- $P_{OUT} = 20$  W MIN. WITH 15 dB GAIN


**.380 4LFL (M113)**

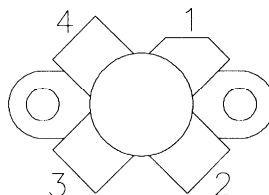
epoxy sealed

**ORDER CODE**

SD1285

**BRANDING**

SD1285

**PIN CONNECTION**


1. Collector

2. Emitter

3. Base

4. Emitter

**DESCRIPTION**

The SD1285 is a 12.5 V epitaxial NPN planar transistor designed primarily for SSB communications. This device utilizes emitter ballasting to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	4.5	A
$P_{DISS}$	Power Dissipation	80	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.2	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**SD1285****ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{E}} = 0\text{mA}$	36	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 50\text{mA}$	$V_{\text{BE}} = 0\text{V}$	36	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$	18	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 5\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CES}}$	$V_{\text{CE}} = 15\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 1\text{A}$	10	—	200	—

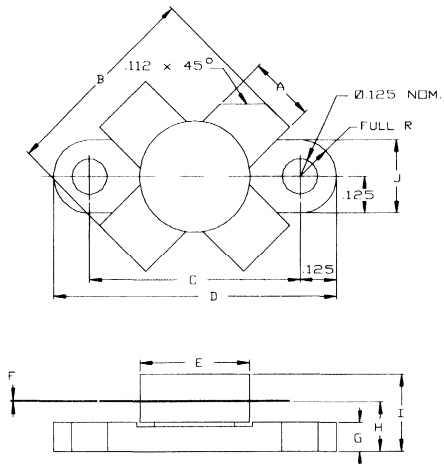
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 30\text{ MHz}$	$V_{\text{CC}} = 12.5\text{ V}$	$I_{\text{CQ}} = 25\text{ mA}$	20	—	—	W
$G_{\text{P}}$	$f = 30\text{ MHz}$	$V_{\text{CC}} = 12.5\text{ V}$	$I_{\text{CQ}} = 25\text{ mA}$	15	18	—	dB
$\text{IMD}$	$f = 30\text{ MHz}$	$V_{\text{CC}} = 12.5\text{ V}$	$I_{\text{CQ}} = 25\text{ mA}$	—	—	- 30	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 12.5\text{ V}$		—	100	—	pF

Note:  $P_{\text{IN}} = 0.65\text{ W}$

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0113

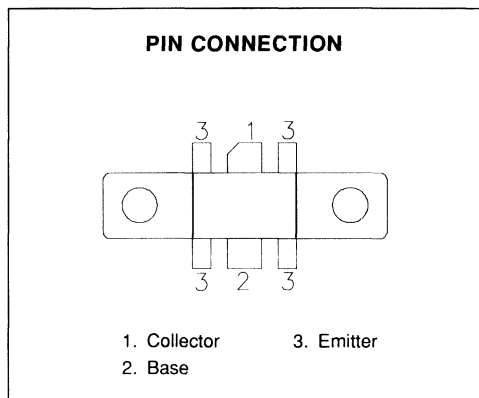
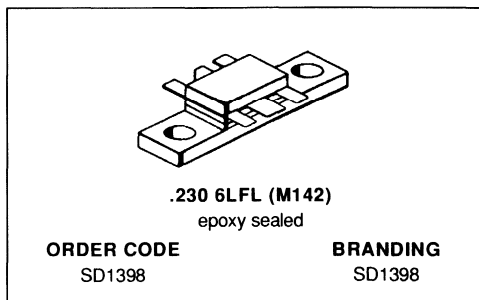


SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.385/9,78
F	.004/0,10	.006/0,15
G	.085/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48



**RF & MICROWAVE TRANSISTORS**  
**850-960 MHz APPLICATIONS**

- 850 - 960 MHz
- 24 VOLTS
- COMMON EMITTER
- OVERLAY GEOMETRY
- GOLD METALLIZATION
- $P_{OUT} = 6.0$  W MIN. WITH 10.0 dB GAIN


**DESCRIPTION**

The SD1398 is a gold metallized epitaxial silicon NPN transistor designed for high linearity Class AB operation cellular base station applications. The SD1398 can also be operated Class C.

The SD1398 is internally input matched and can be used as a driver for the SD1423 or SD1424.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	50	V
$V_{CES}$	Collector-Emitter Voltage	35	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	2.4	A
$P_{DISS}$	Power Dissipation	53	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.3	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CB0</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	50	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 5mA	I <sub>B</sub> = 0mA	24	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CEO</sub>	V <sub>CE</sub> = 24V	I <sub>E</sub> = 0mA	—	—	1.0	mA
I <sub>CB0</sub>	V <sub>CB</sub> = 24V	I <sub>E</sub> = 0mA	—	—	1.0	mA
h <sub>FE</sub>	V <sub>CE</sub> = 10V	I <sub>C</sub> = 0.1A	20	—	100	—

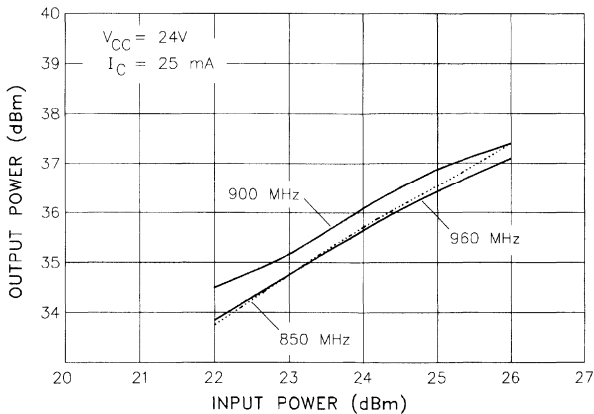
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 850 — 960 MHz	V <sub>CE</sub> = 24 V	I <sub>CQ</sub> = 25 mA	6	—	—	W
η <sub>C</sub>	f = 850 — 960 MHz	V <sub>CE</sub> = 24 V	I <sub>CQ</sub> = 25 mA	—	50	—	%
G <sub>P</sub>	f = 850 — 960 MHz	V <sub>CE</sub> = 24 V	I <sub>CQ</sub> = 25 mA	10	12	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 24 V		—	7.5	8.5	pF

Note: P<sub>IN</sub> = 0.60w

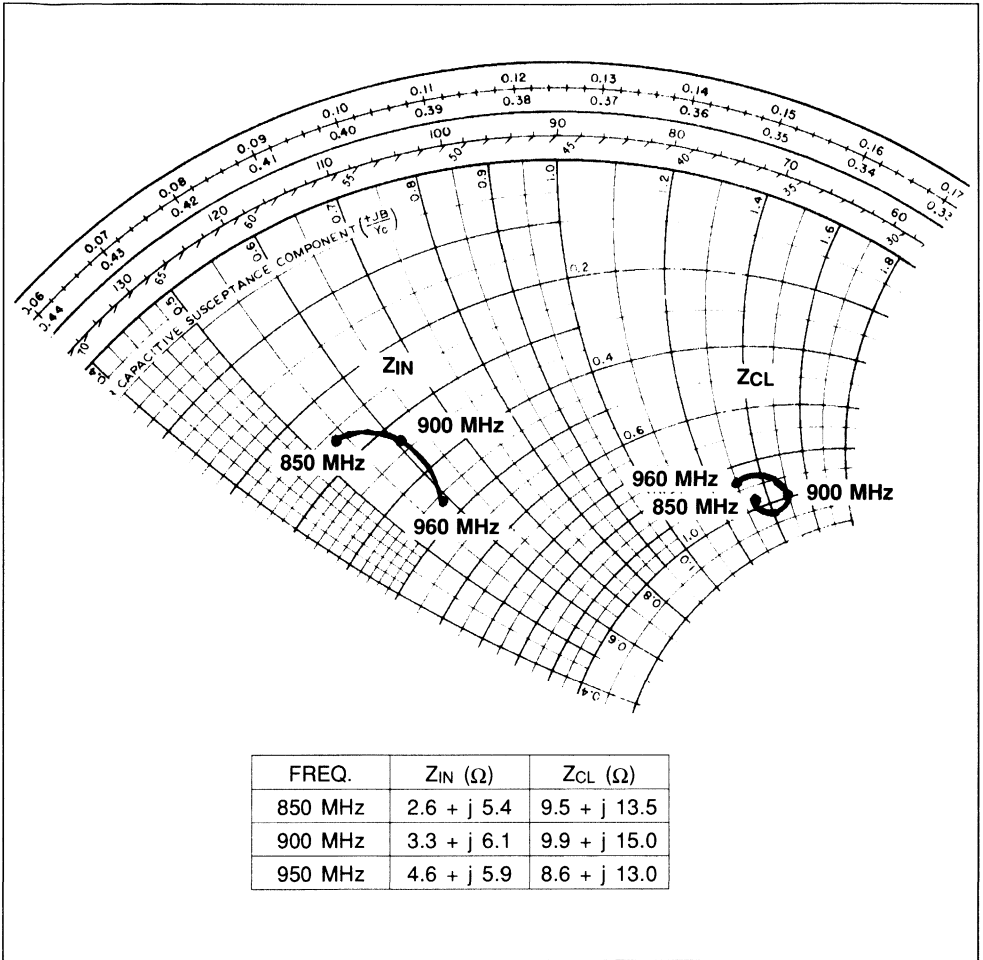
TYPICAL PERFORMANCE

CLASS AB BROADBAND POWER OUTPUT vs POWER INPUT

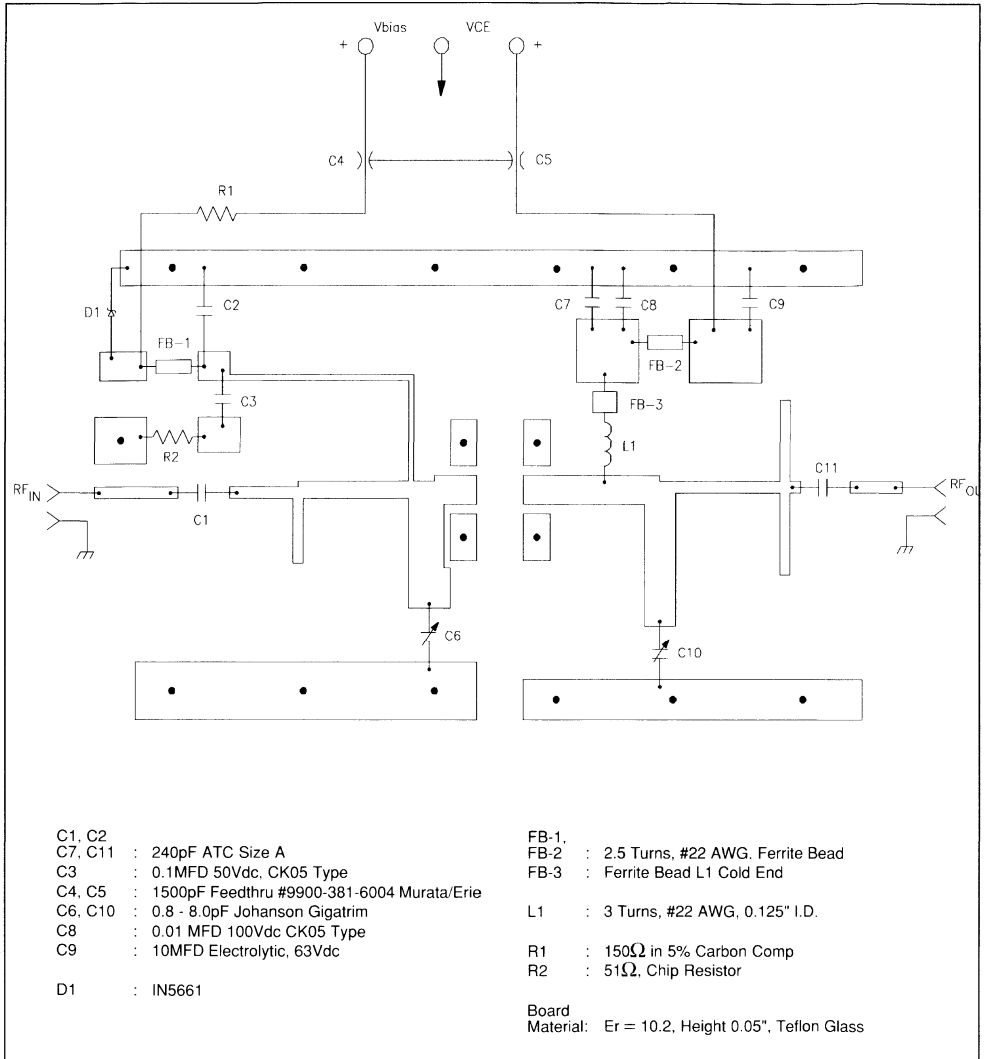




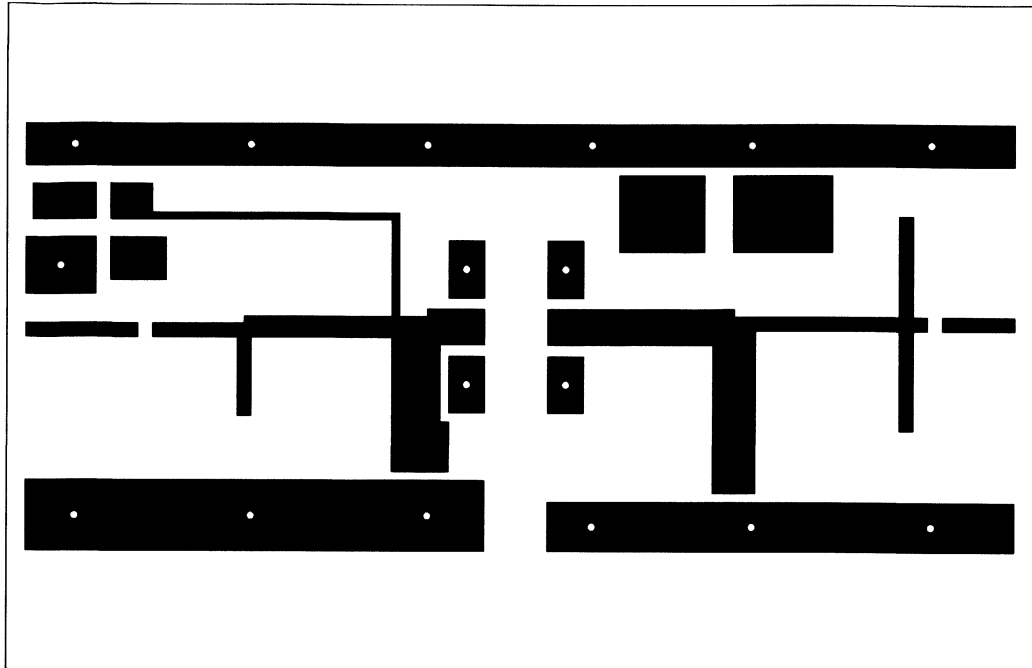
## IMPEDANCE DATA



## TEST CIRCUIT

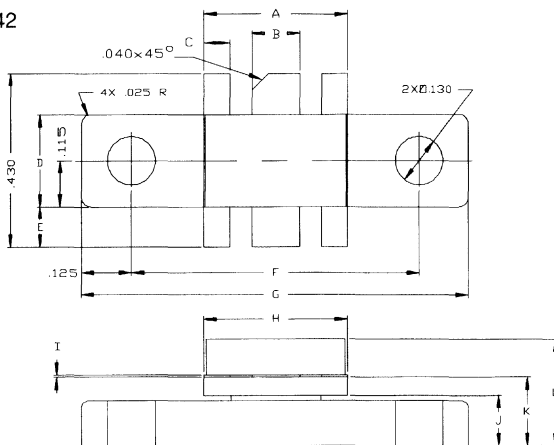


TEST CIRCUIT LAYOUT



PACKAGE MECHANICAL DATA

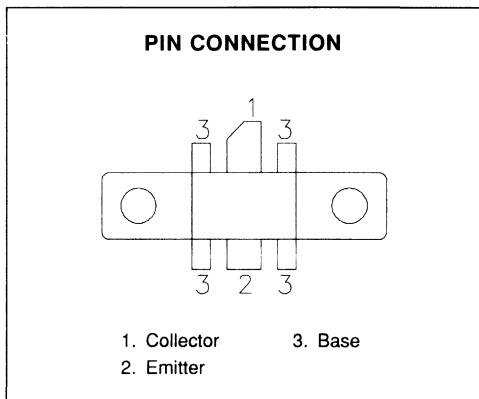
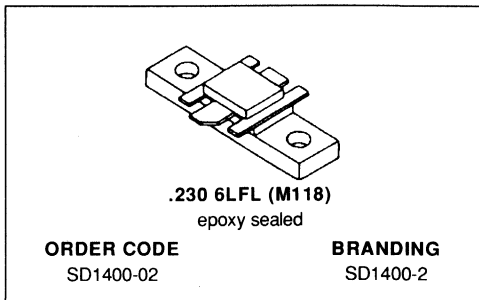
Ref.: Dwg. No.12-0142



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.355/9,02	.365/9,27	K	.160/4,06	.180/4,57
B	.115/2,92	.125/3,18	L	.230/5,84	.260/6,60
C	.075/1,91	.085/2,16			
D	.225/5,72	.235/5,97			
E	.090/2,29	.110/2,79			
F	.720/18,29	.730/18,54			
G	.970/24,64	.980/24,89			
H	.355/9,02	.365/9,27			
I	.004/0,10	.006/0,15			
J	.120/3,05	.130/3,30			

**RF & MICROWAVE TRANSISTORS**  
**800/900 MHz APPLICATIONS**

- 900 MHz
- 24 VOLTS
- COMMON BASE
- EFFICIENCY 55%
- GOLD METALLIZATION
- $P_{OUT} = 14$  W MIN. WITH 9.7 dB GAIN


**DESCRIPTION**

The SD1400-02 is a 24 V Class C epitaxial silicon NPN planar transistor designed for base station applications in cellular telephone systems. The SD1400-02 uses matched input technology (tuned Q) to increase bandwidth and power gain over the 806 - 900 MHz range. It withstands 20:1 VSWR at rated conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	55	V
$V_{CEO}$	Collector-Emitter Voltage	28	V
$V_{CES}$	Collector-Emitter Voltage	55	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	57.5	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.0	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}^*$	$I_C = 50mA$	$V_{BE} = 0V$	55	—	—	V
$BV_{CEO}^*$	$I_C = 50mA$	$I_B = 0mA$	28	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	2.5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	20	—	—	—

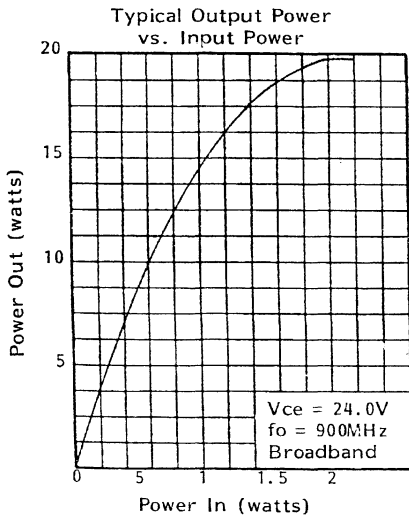
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 900\text{ MHz}$	$P_{IN} = 1.5W$	$V_{CE} = 24\text{ V}$	14	—	—	W
$\eta_C$	$f = 900\text{ MHz}$	$P_{IN} = 1.5W$	$V_{CE} = 24\text{ V}$	—	55	—	%
$G_P$	$f = 900\text{ MHz}$	$P_{IN} = 1.5W$	$V_{CE} = 24\text{ V}$	9.7	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 24\text{ V}$		—	12	—	pF

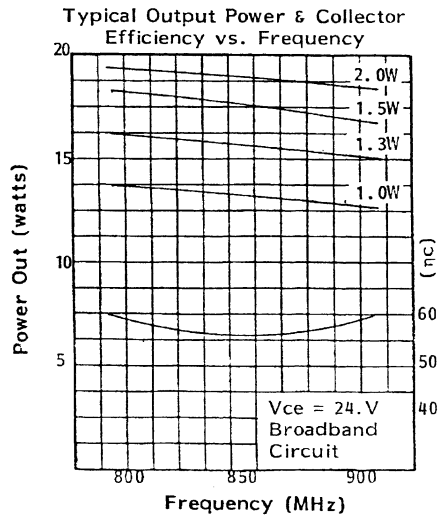
Note: \* Pulsed through 25mH Inductor

**TYPICAL PERFORMANCE**

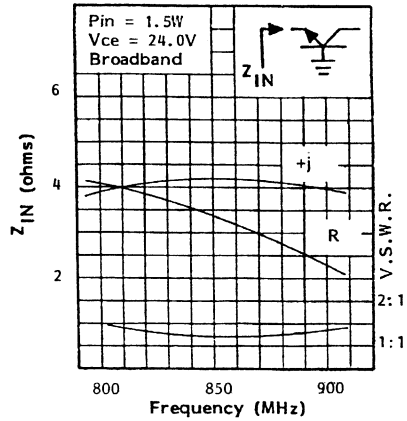
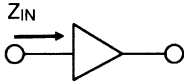
**POWER OUTPUT vs POWER INPUT**



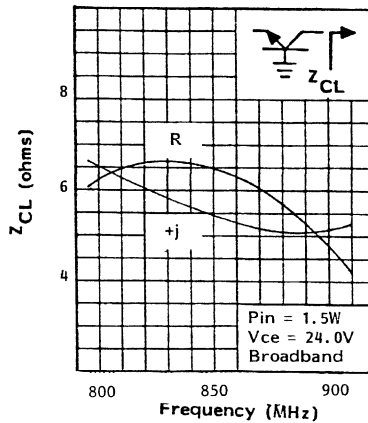
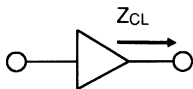
**POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**



## IMPEDANCE DATA

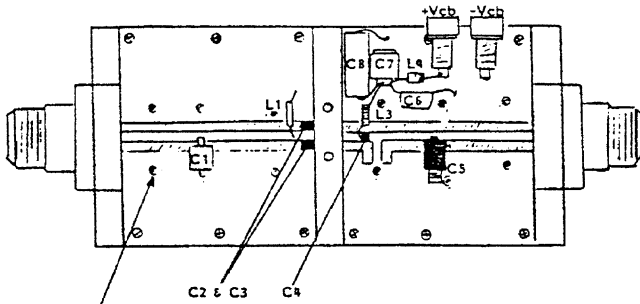
TYPICAL INPUT  
IMPEDANCE

FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
900 MHz	$2.3 + j 4.0$	$4.8 + j 5.2$

TYPICAL COLLECTOR  
LOAD IMPEDANCE

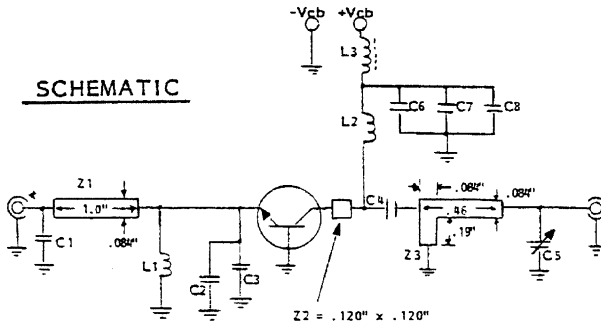
TEST CIRCUIT

LAY-OUT (800-900MHz Vcb = +25V)



Rivets through board to insure ground plane.

SCHMATIC



- C1 : 5pF Unelco
- C2 : 12pF ATC 100 mils Chip Capacitor
- C3 : 12pF ATC 100 mils Chip Capacitor
- C4 : 18pF ATC 100 mils Chip Capacitor
- C5 : 0.6pF ATC 100 mils Chip Capacitor
- C6 : 0.1µF Disc

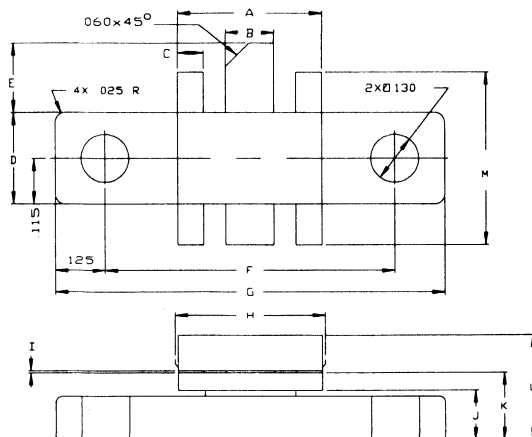
- C7 : 1000pF Unelco
- C8 : 47µF 63V Electrolytic
- L1 : .15mH Molded Choke
- L2 : #24 AWG Insulated 12 Turns with .090" Diameter
- L3 : #22 Enamel with 2 Turns in a Ferroxcube Bead (ferrite) #56-590-65/38

Board Material : Glass Teflon 1/32" Thick #3M-K-6098



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0118

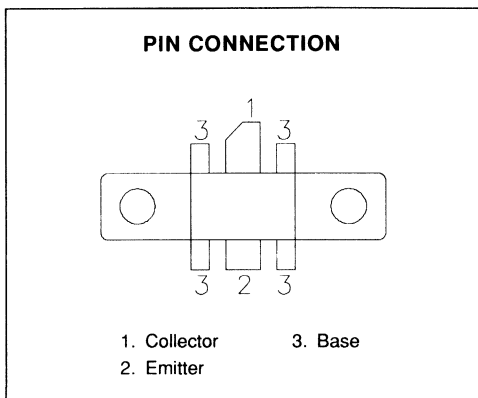
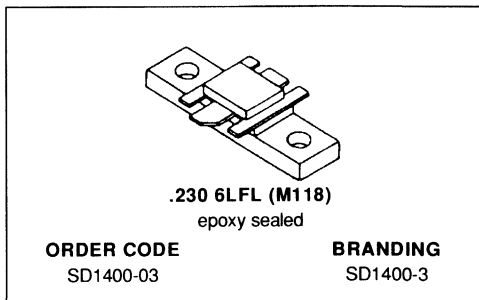


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	355/9,02	365/9,27	K	160/4,06	180/4,57
B	115/2,92	125/3,18	L	250/6,35	275/6,99
C	060/1,52	070/1,78	M	420/10,67	450/11,43
D	225/5,72	235/5,97			
E	150/3,81	170/4,32			
F	720/18,29	730/18,54			
G	970/24,64	980/24,89			
H	355/9,02	365/9,27			
I	004/0,10	006/0,15			
J	120/3,05	130/3,30			



**RF & MICROWAVE TRANSISTORS**  
**800/900 MHz APPLICATIONS**

- 960 MHz
- 24 VOLTS
- COMMON BASE
- EFFICIENCY 50%
- GOLD METALLIZATION
- $P_{OUT} = 14$  W MIN. WITH 9.5 dB GAIN


**DESCRIPTION**

The SD1400-03 is a 24 V Class C epitaxial silicon NPN planar transistor designed for amplifier applications in the 900 - 960 MHz frequency range. Internal input matching and common base configuration assure optimum gain and efficiency across the entire frequency band.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	55	V
$V_{CEO}$	Collector-Emitter Voltage	28	V
$V_{CES}$	Collector-Emitter Voltage	55	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	50	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.5	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

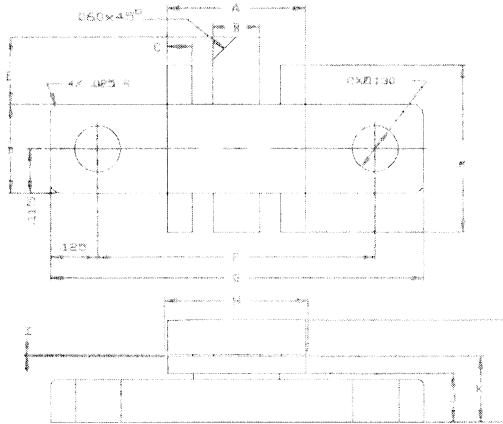
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{\text{CES}}$	$I_{\text{C}} = 50\text{mA}$	$V_{\text{BE}} = 0\text{V}$		55	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$		28	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$		4.0	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 15\text{V}$	$I_{\text{E}} = 0\text{mA}$		—	—	2.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 1\text{A}$		30	—	200	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 1.6\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	14	—	—	W
$\eta_{\text{C}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 1.6\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	50	—	—	%
$G_{\text{P}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 1.6\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	9.5	—	—	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 24\text{ V}$		—	—	18	pF

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0118

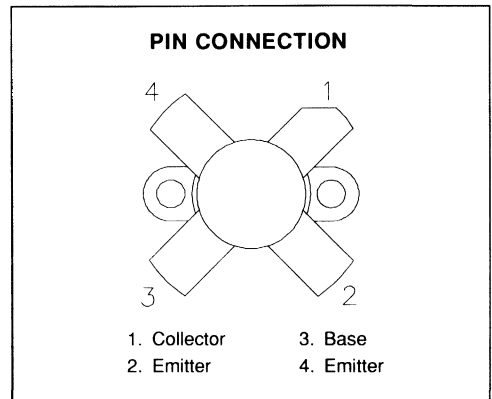
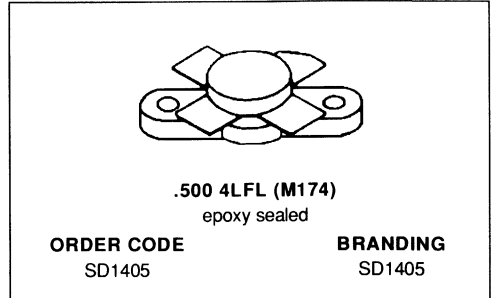


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	355/9.02	365/9.27	K	160/4.06	180/4.57
B	115/2.92	125/3.18	L	250/6.35	275/6.99
C	060/1.52	070/1.78	M	420/10.67	450/11.43
D	225/5.72	235/5.97			
E	150/3.81	170/4.32			
F	720/18.29	730/18.54			
G	970/24.64	980/24.89			
H	355/9.02	365/9.27			
I	004/0.10	006/0.15			
J	120/3.05	130/3.30			



**RF & MICROWAVE TRANSISTORS  
 HF SSB APPLICATIONS**

- 30 MHz
- 12.5 VOLTS
- COMMON EMITTER
- IMD -32 dB
- GOLD METALLIZATION
- $P_{OUT} = 75 \text{ W MIN. WITH } 13 \text{ dB GAIN}$


**DESCRIPTION**

The SD1405 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for HF communications. This device utilizes diffused emitter resistors to achieve infinite VSWR under rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	20	A
$P_{DISS}$	Power Dissipation	270	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.65	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	36	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 100mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 100mA	I <sub>B</sub> = 0mA	18	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 15V	I <sub>E</sub> = 0mA	—	—	15	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 5A	20	—	—	—

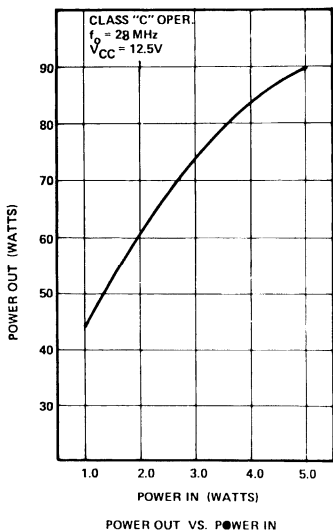
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 30 MHz	P <sub>IN</sub> = 3.8 W	V <sub>CE</sub> = 12.5 V	75	—	—	W
G <sub>P</sub>	f = 30 MHz	P <sub>IN</sub> = 3.8 W	V <sub>CE</sub> = 12.5 V	13	—	—	dB
IMD*	f = 30 MHz	V <sub>CE</sub> = 12.5 V	I <sub>CQ</sub> = 100 mA	-32	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12 V		—	350	—	pF

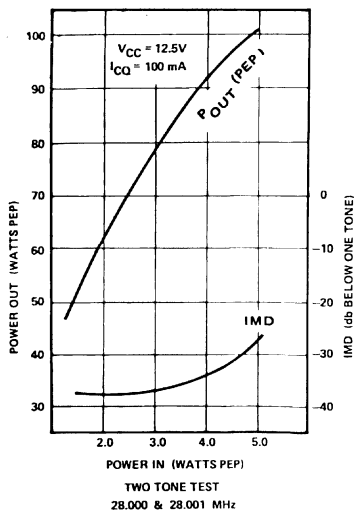
Note: \*P<sub>OUT</sub> = 60WPEP, f<sub>0</sub> = 30 + 30.001 MHz

TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

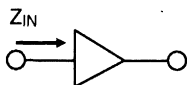
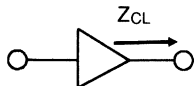


POWER OUTPUT vs POWER INPUT TWO TONE TEST



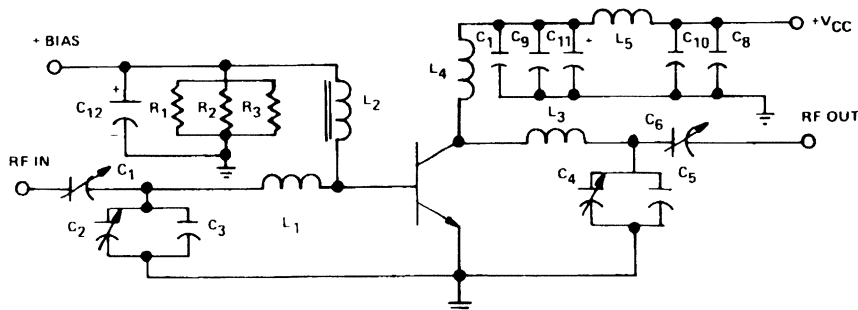
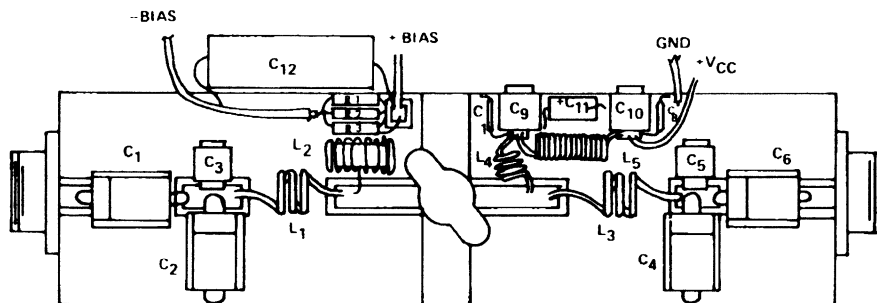


## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
30 MHz	0.7 + j 0.75	1.2 + j 1.0

## TEST CIRCUIT

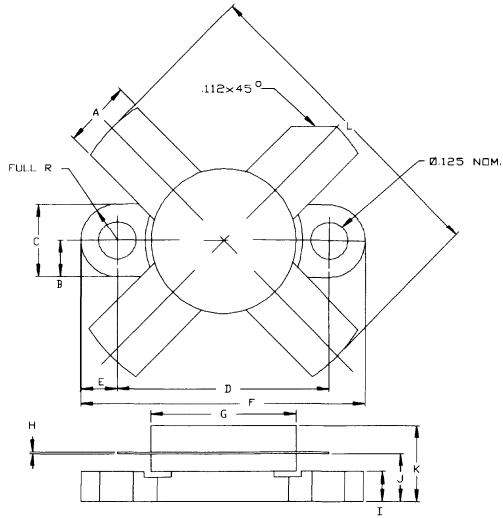


- C1 : 9 - 180 pF, Arco 463  
 C2, C4 : 5 - 380pF, Arco 465  
 C3, C5 : 200pF, Unelco  
 C6 : 110 - 580pF, Arco 467  
 C7, C8 : 0.1μF Ceramic Disk  
 C9, C10 : 1000pF, Unelco  
 C11 : 10μF, Electrolytic, 35Vdc  
 C12 : 1000μF, Electrolytic, 50Vdc

- L1, L3 : 2 1/2 Turns, #14 AWG, 1/4" I.D. Loose Wound  
 L2 : 16 Turns, #16 AWG, Enameled Wire On  
 Micrometals Torroid #T-94  
 L4 : 3 1/2 Turns, #16 AWG, Enameled Wire, 1/4" I.D.  
 L5 : 14 Turns, #16 AWG, Enameled Wire, 1/4" I.D.  
 R1, R2, R3 : 1.5 Ohm, 1 Watt Carbon

PACKAGE MECHANICAL DATA

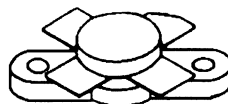
Ref.: Dwg. No.12-0174



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K		.280/7,11
B	.125/3,18		L		1.050/26,67
C	.245/6,22	.255/6,48			
D	.720/18,28	.730/18,54			
E	.125/3,18				
F	.970/24,64	.980/24,89			
G	.495/12,57	.505/12,83			
H	.003/0,08	.007/0,18			
J	.090/2,29	.110/2,79			
J	.160/4,06	.175/4,45			

**RF & MICROWAVE TRANSISTORS**  
**HF SSB APPLICATIONS**

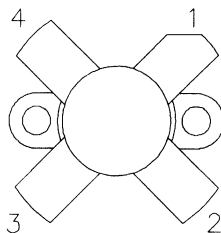
- 30 MHz
- 28 VOLTS
- IMD -30 dB
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 125$  W MIN. WITH 15 dB GAIN



**.500 4LFL (M174)**  
epoxy sealed

**ORDER CODE**  
SD1407

**BRANDING**  
1407

**PIN CONNECTION**


1. Collector      3. Base  
2. Emitter        4. Emitter

**DESCRIPTION**

The SD1407 is a 28 V epitaxial silicon NPN planar transistor designed primarily for SSB communications. This device utilizes state-of-the-art diffused emitter ballasting for improved ruggedness and reliability.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	20	A
$P_{DISS}$	Power Dissipation	270	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.65	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{E}} = 0\text{mA}$	65	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 100\text{mA}$	$V_{\text{BE}} = 0\text{V}$	65	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{B}} = 0\text{mA}$	35	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CES}}$	$V_{\text{CE}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	15	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 5\text{A}$	10	—	200	—

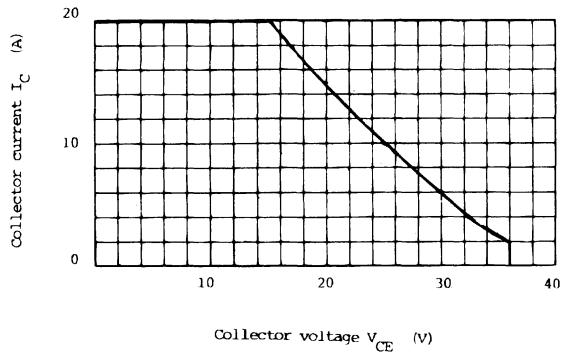
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 30\text{ MHz}$	$P_{\text{IN}} = 3.95\text{ W}$	$V_{\text{CE}} = 28\text{ V}$	125	—	—	W
$G_{\text{P}}$	$f = 30\text{ MHz}$	$P_{\text{IN}} = 3.95\text{ W}$	$V_{\text{CE}} = 28\text{ V}$	15	16	—	dB
$\text{IMD}^*$	$f = 30\text{ MHz}$	$V_{\text{CE}} = 28\text{ V}$	$I_{\text{CQ}} = 100\text{ mA}$	—	-34	-30	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 30\text{ V}$		—	250	—	pF

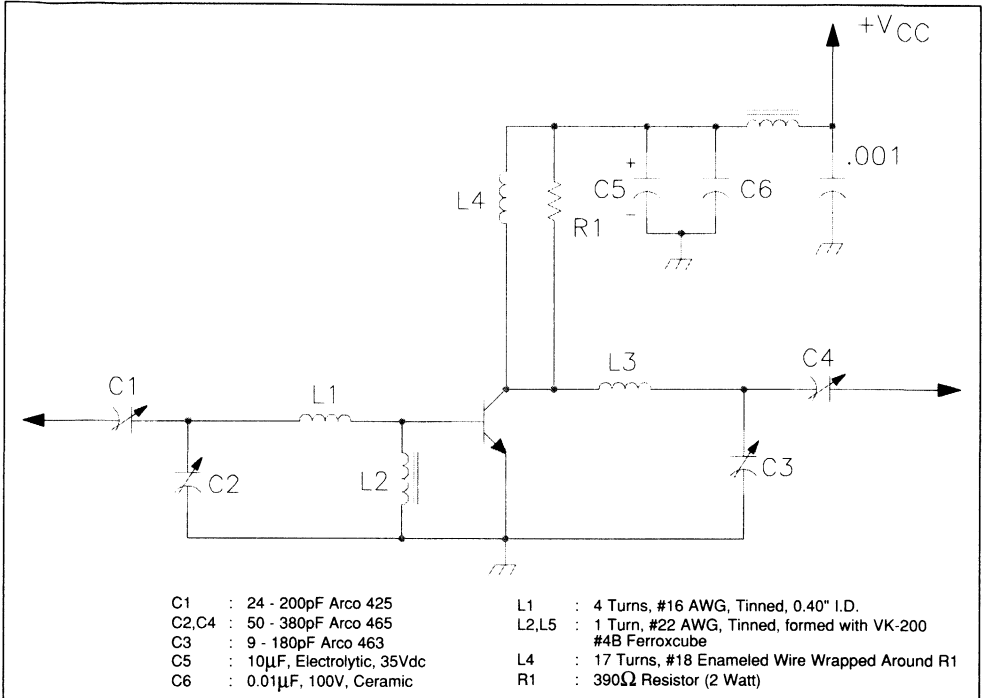
Note: \* $P_{\text{OUT}} = 100\text{W PEP}$ ,  $f_0 = 30 + 30.001\text{ MHz}$

## TYPICAL PERFORMANCE

## SAFE OPERATING AREA

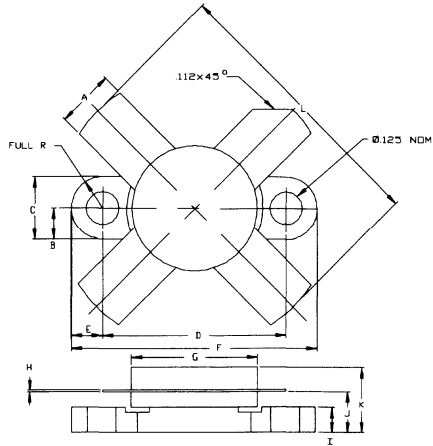


## TEST CIRCUIT



PACKAGE MECHANICAL DATA

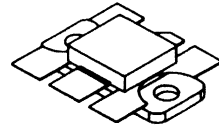
Ref.: Dwg. No.12-0174



SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K	.280/7,11
B	.125/3,18		L	1.050/26,67
C	.245/6,22	.255/6,48		
D	.720/18,28	.730/18,54		
E	.125/3,18			
F	.970/24,64	.980/24,89		
G	.495/12,57	.505/12,83		
H	.003/0,08	.007/0,18		
I	.090/2,29	.110/2,79		
J	.160/4,06	.175/4,45		

**RF & MICROWAVE TRANSISTORS**  
**HF SSB APPLICATIONS**

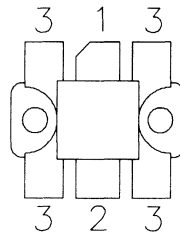
- 30 MHz
- 40 VOLTS
- IMD -30 dB
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 200$  W MIN. WITH 16 dB GAIN



**.400 x .425 6LFL (M153)**  
 epoxy sealed

**ORDER CODE**  
 SD1411

**BRANDING**  
 SD1411

**PIN CONNECTION**


1. Collector                      3. Emitter  
 2. Base

**DESCRIPTION**

The SD1411 is a silicon NPN transistor designed for telecommunications in HF and VHF frequency bands. This device utilizes gold metallized die with diffused emitter resistors to achieve high reliability and ruggedness.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	110	V
$V_{CEO}$	Collector-Emitter Voltage	55	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	40	A
$P_{DISS}$	Power Dissipation	330	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.36	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 200mA$	$I_E = 0mA$	110	—	—	V
$BV_{CES}$	$I_C = 200mA$	$V_{BE} = 0V$	110	—	—	V
$BV_{CER}$	$I_C = 200mA$	$R_{BE} = 10\Omega$	100	—	—	V
$BV_{CEO}$	$I_C = 200mA$	$I_B = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 45V$	$I_E = 0mA$	—	—	20	mA
$h_{FE}$	$V_{CE} = 6V$	$I_C = 10A$	15	—	80	—

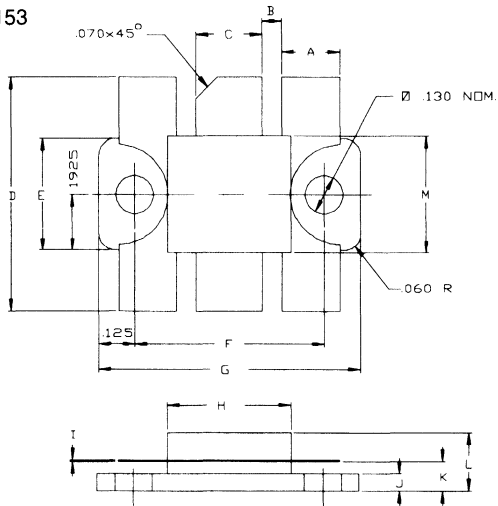
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 30\text{ MHz}$	$V_{CE} = 40\text{ V}$	$I_{CQ} = 150\text{ mA}$	200	—	—	W
GP	$f = 30\text{ MHz}$	$V_{CE} = 40\text{ V}$	$I_{CQ} = 150\text{ mA}$	16	—	—	dB
IMD	$f = 30\text{ MHz}$	$V_{CE} = 40\text{ V}$	$I_{CQ} = 150\text{ mA}$	—	—	-30	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 50\text{ V}$		—	—	360	pF



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0153

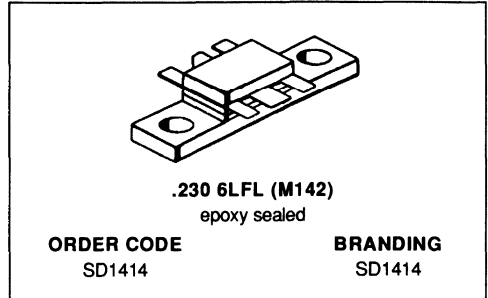


SGS-THOMSON MICROELECTRONICS		CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.195/4,95	.205/5,21	K	.095/2,41
B	.067/1,70		L	.220/5,59
C	.220/5,59	.230/5,84	M	.395/10,03
D	.790/20,07	.810/20,57		.405/10,29
E	.380/9,65	.390/9,91		
F	.645/16,38	.655/16,64		
G	.885/22,48	.905/22,98		
H	.420/10,67	.430/10,92		
I	.003/0,08	.007/0,18		
J	.055/1,40	.065/1,65		

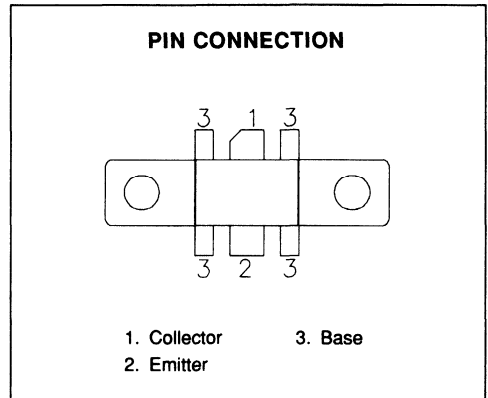


**RF & MICROWAVE TRANSISTORS**  
**800-900 MHz APPLICATIONS**

- 836 MHz
- 12.5 VOLTS
- COMMON BASE
- $P_{OUT} = 45 \text{ W MIN. WITH } 4.7 \text{ dB GAIN}$


**DESCRIPTION**

The SD1414 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed for amplifier applications in the 806 - 866 MHz frequency range. Internal input matching and common base configuration assure optimum gain and efficiency across the entire frequency band. The SD1414 withstands infinite VSWR at rated power output.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	9.0	A
$P_{DISS}$	Power Dissipation	150	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.2	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

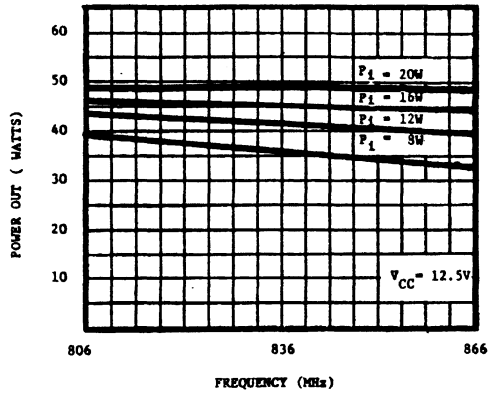
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 50mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 50mA	I <sub>B</sub> = 0mA	18	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 15V	I <sub>E</sub> = 0mA	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	5	—	200	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 836 MHz	P <sub>IN</sub> = 15 W	V <sub>CE</sub> = 12.5 V	45	—	—	W
G <sub>P</sub>	f = 836 MHz	P <sub>IN</sub> = 15 W	V <sub>CE</sub> = 12.5 V	4.7	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12.5 V		—	80	—	pF

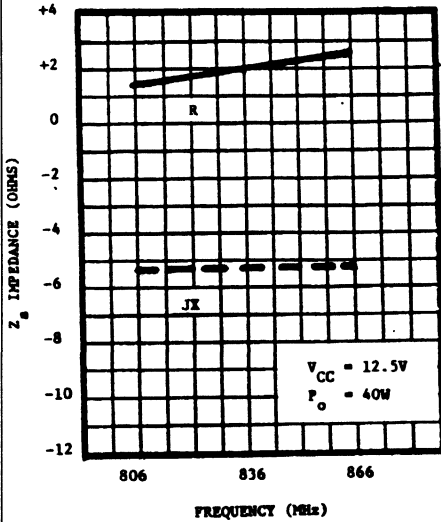
TYPICAL PERFORMANCE

POWER OUTPUT vs FREQUENCY

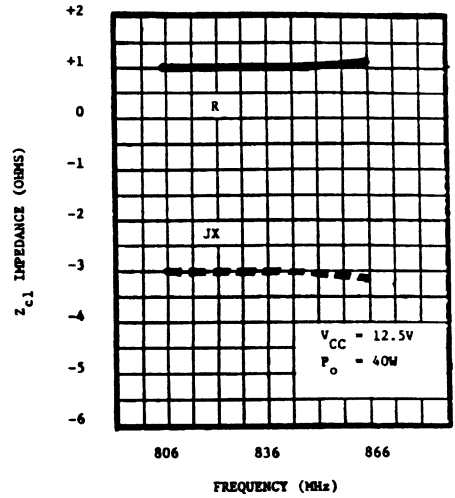


## IMPEDANCE DATA

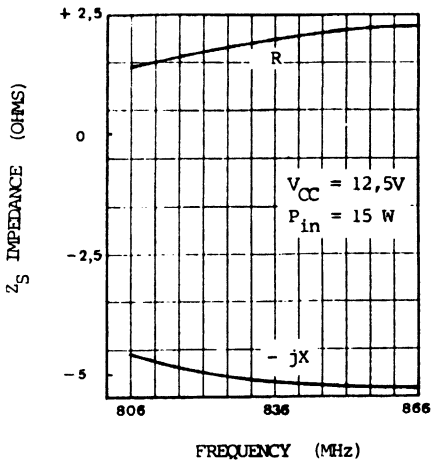
TYPICAL INPUT IMPEDANCE



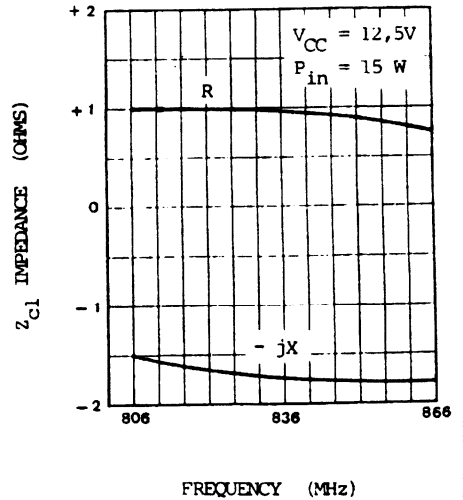
TYPICAL COLLECTOR LOAD IMPEDANCE



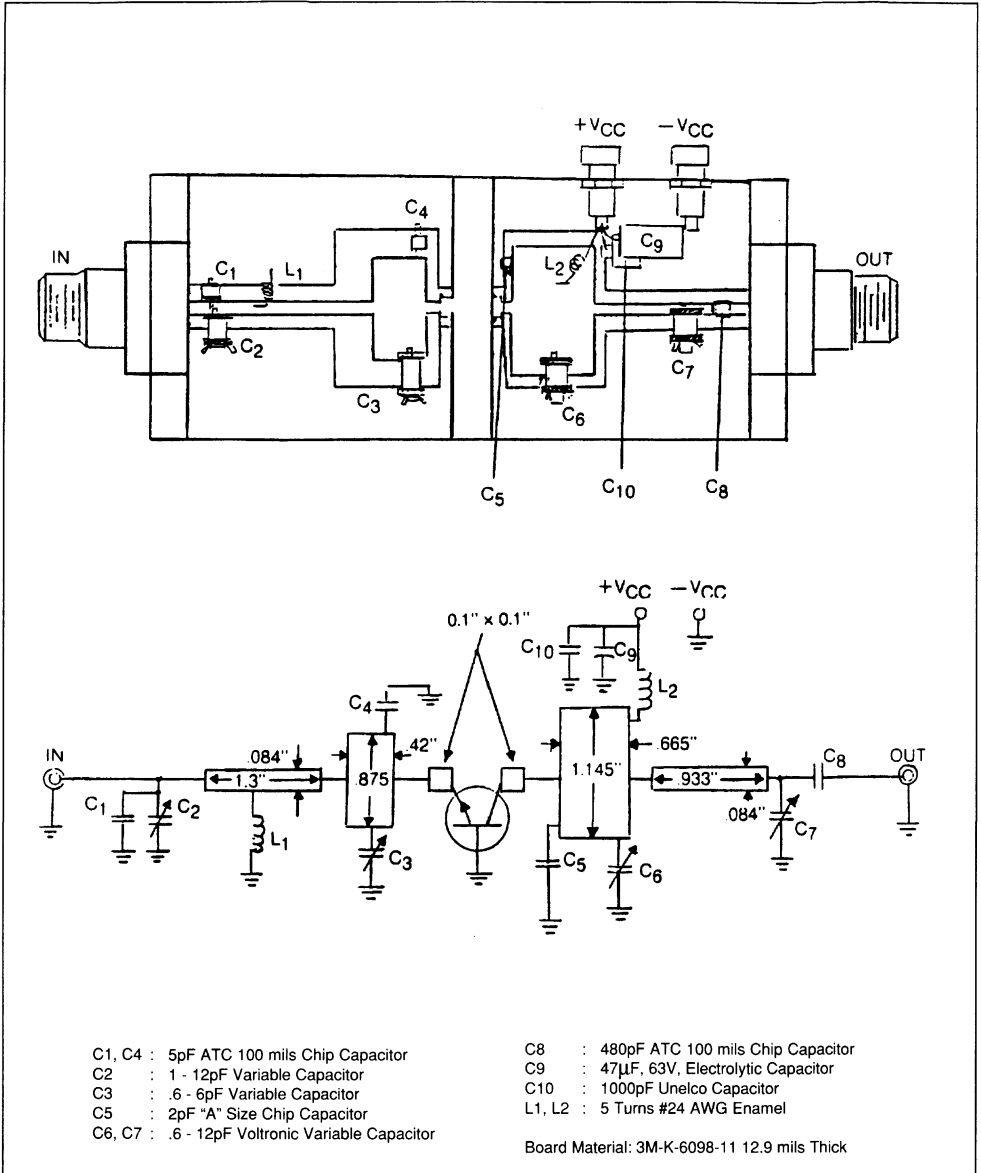
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

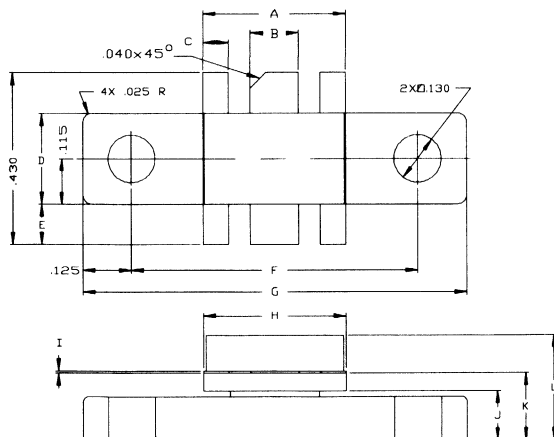


## TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0



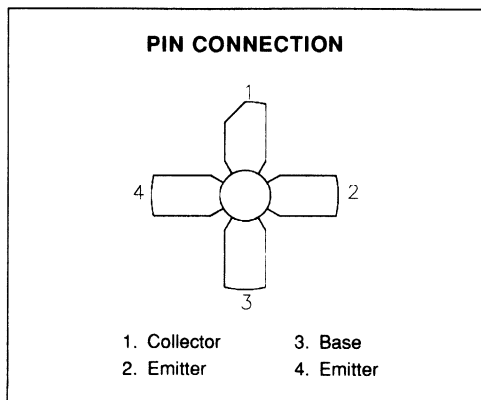
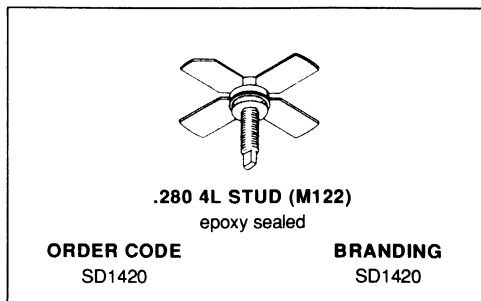
SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.355/9,02	.365/9,27	K	.160/4,06	.180/4,57
B	.115/2,92	.125/3,18	L	.230/5,84	.260/6,60
C	.075/1,91	.085/2,16			
D	.225/5,72	.235/5,97			
E	.090/2,29	.110/2,79			
F	.720/18,29	.730/18,54			
G	.970/24,64	.980/24,89			
H	.355/9,02	.365/9,27			
I	.004/0,10	.006/0,15			
J	.120/3,05	.130/3,30			





**RF & MICROWAVE TRANSISTORS**  
**800-900 MHz BASE STATION APPLICATIONS**

- 860 - 960 MHz
- 24 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- CLASS A LINEAR OPERATION
- $P_{OUT} = 2.1 \text{ W MIN. WITH } 9.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1420 is a gold metallized epitaxial silicon NPN planar transistor designed for high linearity Class A operation Cellular Base Station applications. The SD1420 is also available in a studless package as the SD1420-01.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	40	V
$V_{CEO}$	Collector-Emitter Voltage	28	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	.250	A
$P_{DISS}$	Power Dissipation	7	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 55 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	20	$^{\circ}\text{C/W}$
---------------	----------------------------------	----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$	40	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{B}} = 0\text{mA}$	28	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 24\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$	20	—	120	—

## DYNAMIC

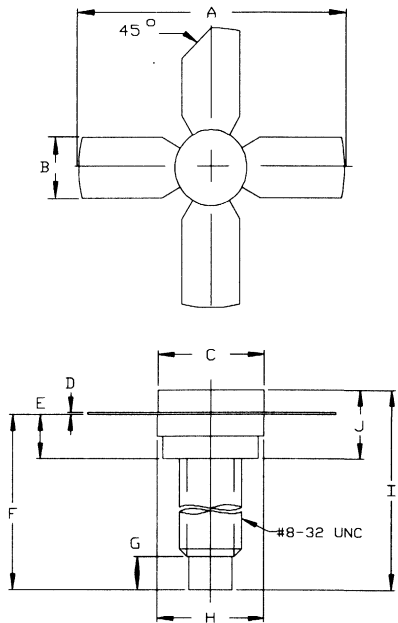
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 960\text{ MHz}$	$V_{\text{CE}} = 24\text{ V}$	$I_{\text{CQ}} = 200\text{mA}$	2.1	—	—	W
GP	$f = 960\text{ MHz}$	$V_{\text{CE}} = 24\text{ V}$	$I_{\text{CQ}} = 200\text{mA}$	8.9	9.0	—	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		—	—	5	pF

Note: \* $P_{\text{IN}} = 0.27\text{ W}$

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0122

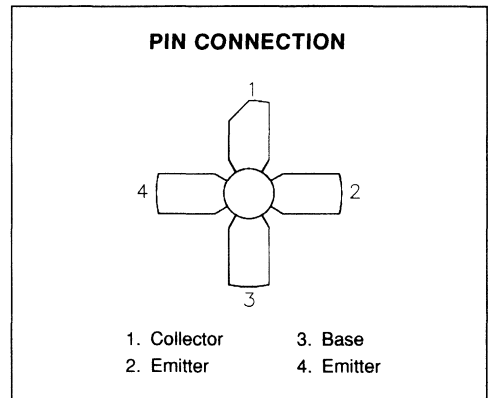
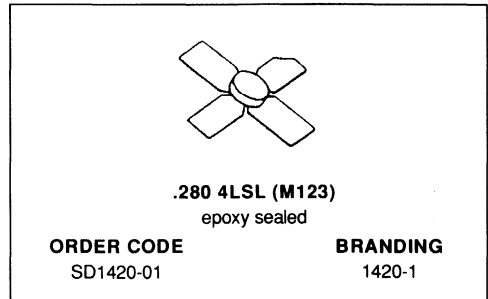
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51





## RF & MICROWAVE TRANSISTORS 800-900 MHz BASE STATION APPLICATIONS

- 860 - 960 MHz
- 24 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- CLASS A LINEAR OPERATION
- $P_{OUT} = 0.9 \text{ W MIN. WITH } 9.5 \text{ dB GAIN}$



### DESCRIPTION

The SD1420 is a gold metallized epitaxial silicon NPN planar transistor designed for high linearity Class A operation Cellular Base Station applications. The SD1420-01 is also available in a stud package as the SD1420.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	40	V
$V_{CEO}$	Collector-Emitter Voltage	28	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	.250	A
$P_{DISS}$	Power Dissipation	7	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 55 to +150	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	20	$^{\circ}\text{C/W}$
---------------	----------------------------------	----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$	40	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{B}} = 0\text{mA}$	28	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 24\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$	20	—	120	—

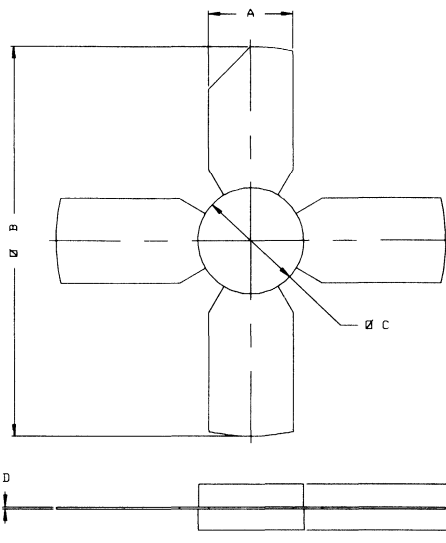
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 960\text{ MHz}$	$V_{\text{CE}} = 24\text{ V}$	$I_{\text{CQ}} = 125\text{ mA}$	0.9	—	—	W
$G_{\text{P}}$	$f = 960\text{ MHz}$	$V_{\text{CE}} = 24\text{ V}$	$I_{\text{CQ}} = 125\text{ mA}$	9.5	—	—	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		—	—	5	pF

Note:  $P_{\text{IN}} = 0.1\text{ W}$

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0123



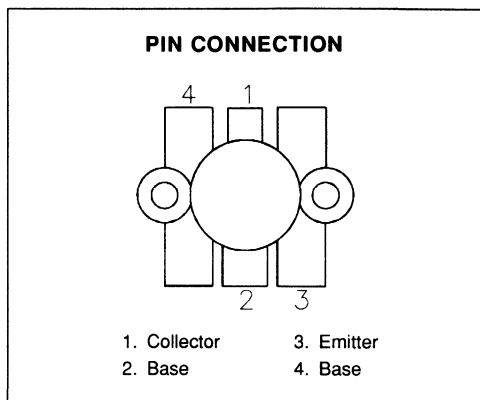
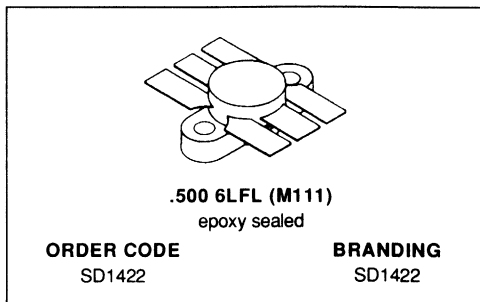
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	-----	1.055/26,8
C	.275/6,99	.285/7,24
D	.004/0,10	.006/0,15
E	.050/1,27	.060/1,52
F	.118/3,00	.130/3,30





## RF & MICROWAVE TRANSISTORS UHF MOBILE APPLICATIONS

- 470 MHz
- 12.5 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- P<sub>OUT</sub> = 25 W MIN. WITH 6.2 dB GAIN



### DESCRIPTION

The SD1422 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed for broadband applications in the 450 - 512 MHz land mobile radio band. This device utilizes diffused emitter resistors to withstand 20:1 VSWR at rated operating conditions.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	36	V
V <sub>CEO</sub>	Collector-Emitter Voltage	16	V
V <sub>CES</sub>	Collector-Emitter Voltage	36	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	4.8	A
P <sub>DISS</sub>	Power Dissipation	70	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	2.5	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

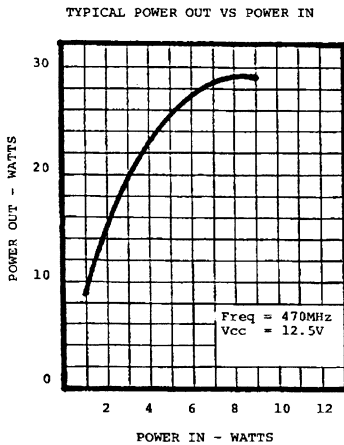
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 10mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	16	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 12.5V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	10	—	—	—

**DYNAMIC**

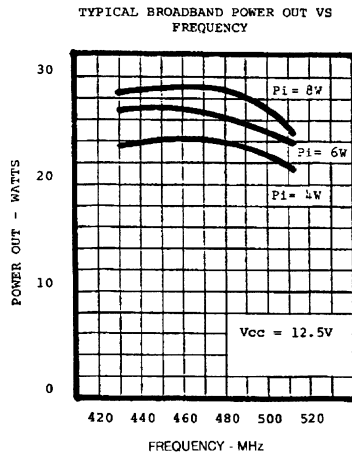
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 470\text{ MHz}$	$P_{IN} = 6.0\text{ W}$	$V_{CC} = 12.5\text{ V}$	25	—	—	W
$G_P$	$f = 470\text{ MHz}$	$P_{IN} = 6.0\text{ W}$	$V_{CC} = 12.5\text{ V}$	6.2	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 12.5\text{ V}$		—	70	—	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

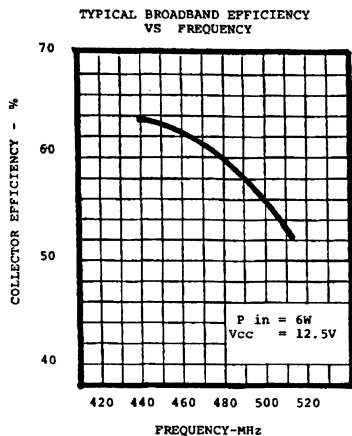


**BROADBAND POWER OUTPUT vs FREQUENCY**

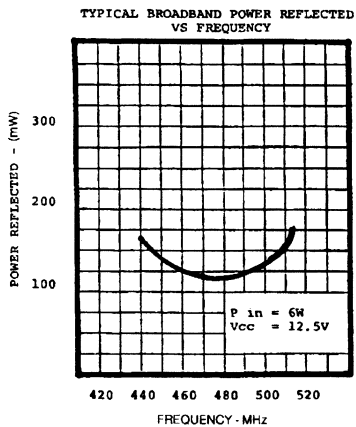


## TYPICAL PERFORMANCE (cont'd)

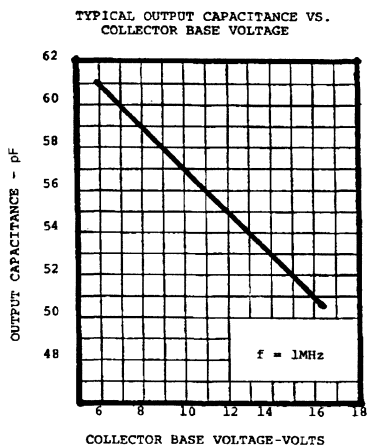
## COLLECTOR EFFICIENCY vs FREQUENCY



## BROADBAND POWER REFLECTED vs FREQUENCY



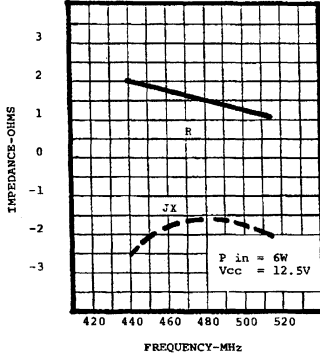
## OUTPUT CAPACITANCE vs COLECTOR BASE VOLTAGE



IMPEDANCE DATA

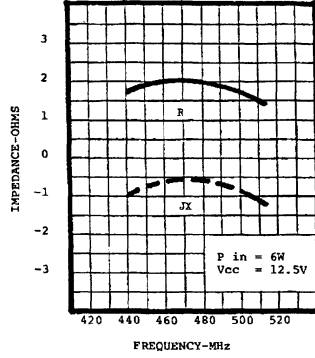
TYPICAL INPUT  
IMPEDANCE

TYPICAL SERIES SOURCE IMPEDANCE  
VS FREQUENCY

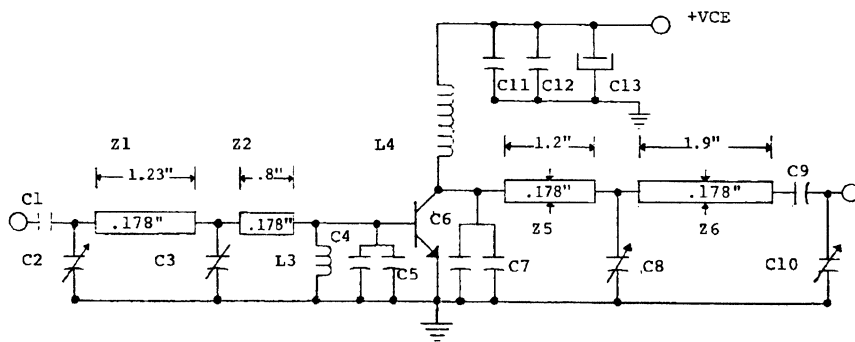
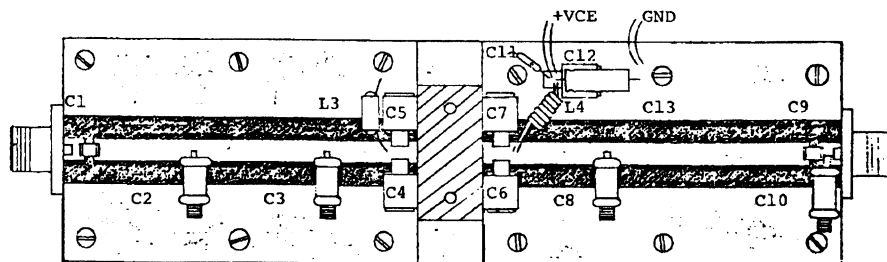


TYPICAL COLLECTOR  
LOAD IMPEDANCE

TYPICAL SERIES COLLECTOR LOAD  
VS FREQUENCY



## TEST CIRCUIT



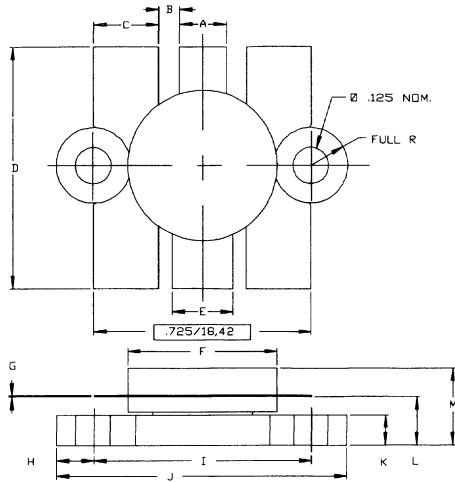
C1 : ATC 100mils Chip Capacitor 75pF  
 C2, C3 : Volttronics Air Variable 1-14pF  
 C4, C5 : 27pF Unelco  
 C6, C7 : 36pF Unelco  
 C9 : ATC 100mils Chip Capacitor 750pF  
 C11 : 0.10 $\mu$ F, 25V, Erie Disc Capacitor  
 C12 : 1000pF Unelco  
 C13 : 8.2 $\mu$ F, 25V, Emectronic Capacitor

L3 : VK200 21/4B Ferroxcube 1 1/2 Turn  
 L4 : 7 Turns #18 AWG .2" I.D. with Wire Spacing  
 Z1 : 50 $\Omega$  Microstrip .178" x 1.23"  
 Z2 : 50 $\Omega$  Microstrip .178" x .8"  
 Z5 : 50 $\Omega$  Microstrip .178" x 1.2"  
 Z6 : 50 $\Omega$  Microstrip .178" x 1.9"

Board Material: 3M-k6098 1/16" Thick

PACKAGE MECHANICAL DATA

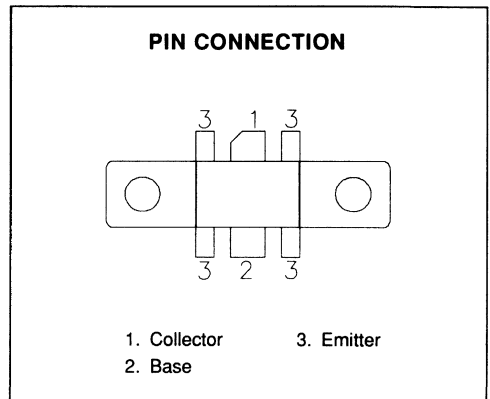
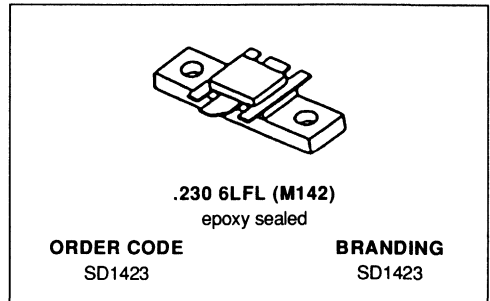
Ref.: Dwg. No.12-0111



SGS-THOMSON MICROELECTRONICS		CENT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41
B	.045/1,14		L	.150/3,81
C	.210/5,33	.220/5,59	M	.280/7,11
D	.835/21,21	.865/21,97		
E	.200/5,08	.210/5,33		
F	.490/12,45	.510/12,95		
G	.003/0,08	.007/0,18		
H	.125/3,18			
I	.720/18,29	.730/18,54		
J	.970/24,64	.980/24,89		

**RF & MICROWAVE TRANSISTORS**  
**800-960MHz BASE STATION APPLICATIONS**

- 800 - 960 MHz
- 24 VOLTS
- EFFICIENCY 50%
- COMMON EMITTER
- GOLD METALLIZATION
- CLASS AB LINEAR OPERATION
- $P_{OUT} = 15 \text{ W MIN. WITH } 8.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1423 is a gold metallization epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation for cellular base station applications. The SD1423 is designed as a medium power output device or as the driver for the SD1424.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	48	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{CES}$	Collector-Emitter Voltage	45	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	2.5	A
$P_{DISS}$	Power Dissipation	29	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	6	$^{\circ}\text{C/W}$
---------------	----------------------------------	---	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

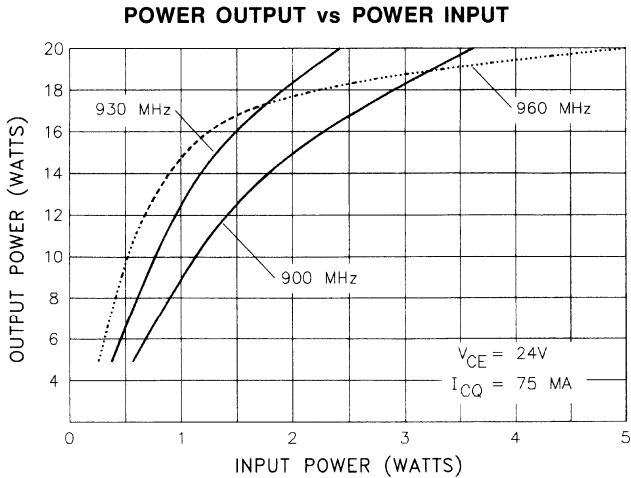
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	48	50	—	V
$BV_{CEO}$	$I_C = 20mA$	$I_B = 0mA$	25	30	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	4.0	—	V
$I_{CBO}$	$V_{CB} = 24V$	$I_E = 0mA$	—	—	1.0	mA
$h_{FE}$	$V_{CE} = 10V$	$I_C = 100mA$	20	—	100	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 960\text{ MHz}$	$V_{CC} = 24\text{ V}$	$I_{CQ} = 75\text{ mA}$	15	—	—	W
$G_P$	$f = 960\text{ MHz}$	$V_{CC} = 24\text{ V}$	$I_{CQ} = 75\text{ mA}$	8	—	—	dB
$\eta_c$	$f = 960\text{ MHz}$	$V_{CC} = 24\text{ V}$	$I_{CQ} = 75\text{ mA}$	45	50	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 24V$		—	20	24	pF

Note:  $P_{IN} = 2.4\text{ W}$

**TYPICAL PERFORMANCE**





## IMPEDANCE DATA

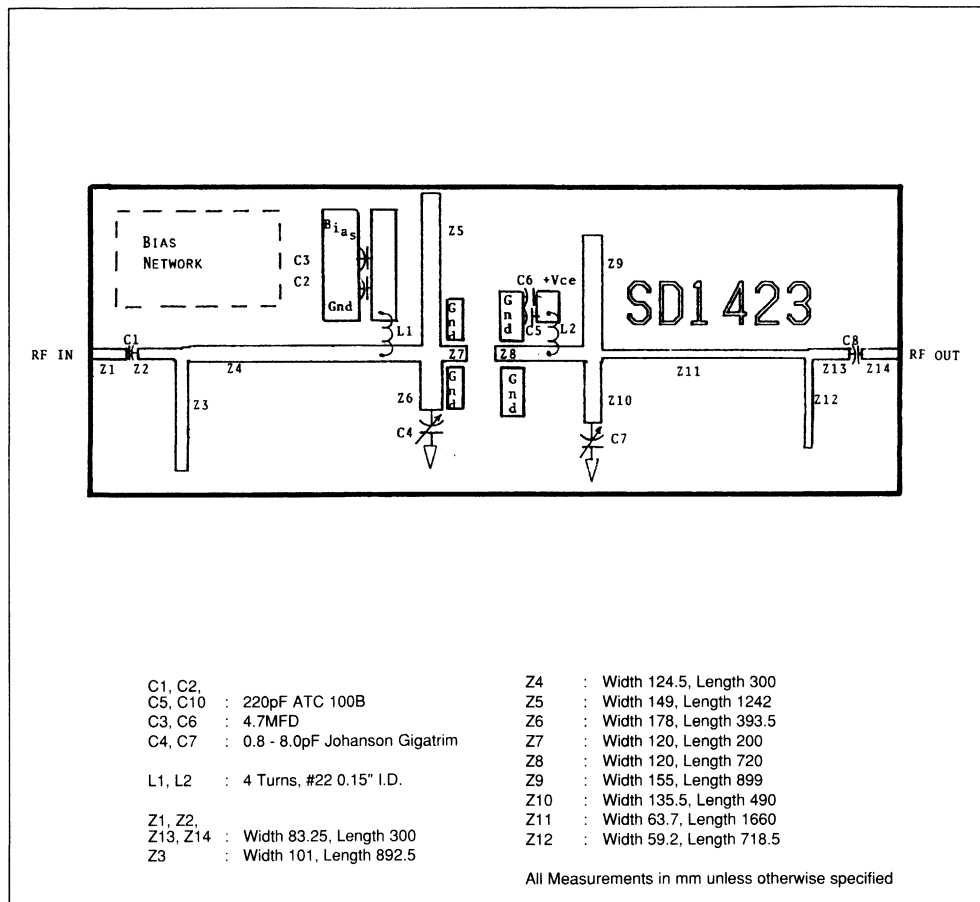
FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
900 MHz	$1.30 + j 1.98$	$3.99 + j 5.55$
930 MHz	$1.42 + j 2.31$	$3.18 + j 4.97$
960 MHz	$1.45 + j 2.62$	$2.96 + j 4.07$

$P_{OUT} = 15 \text{ W}$

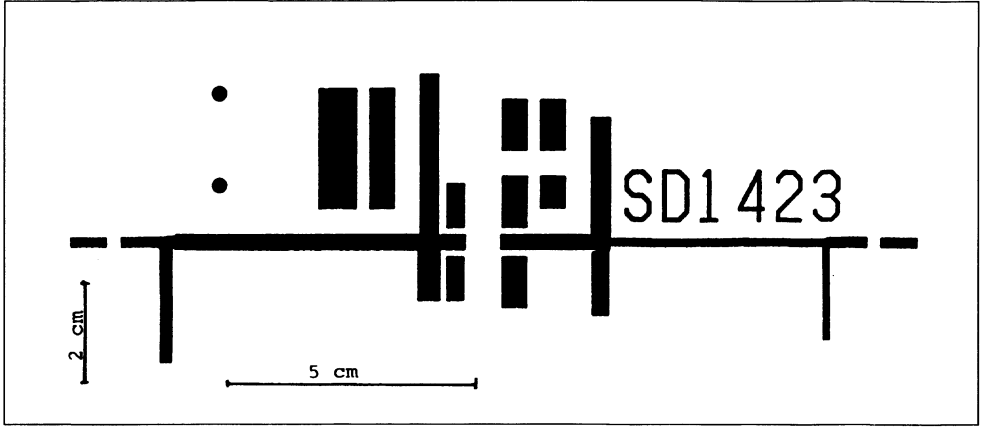
$V_{CE} = 75 \text{ mA}$

$I_{CQ} = 24 \text{ V}$

## TEST CIRCUIT

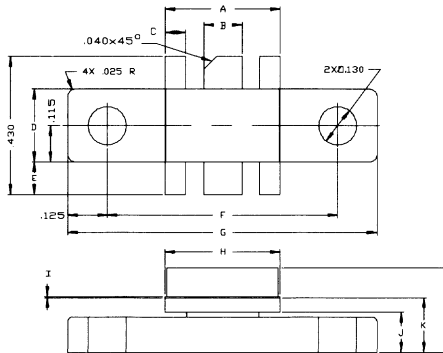


TEST CIRCUIT LAYOUT



PACKAGE MECHANICAL DATA

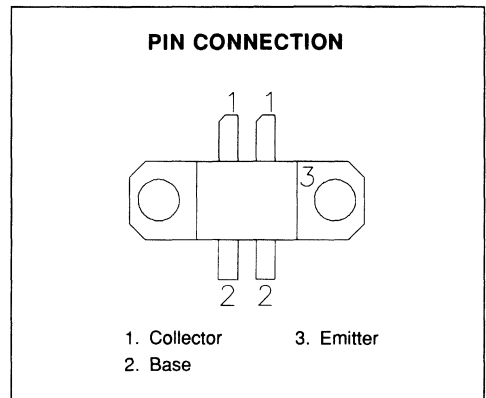
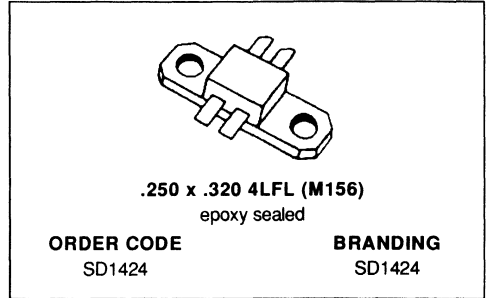
Ref.: Dwg. No.12-0142



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.353/9,02	.363/9,27	K	.160/4,06	.180/4,57
B	.115/2,92	.125/3,18	L	.230/5,84	.260/6,60
C	.075/1,91	.085/2,16			
D	.225/5,72	.235/5,97			
E	.090/2,29	.110/2,79			
F	.720/18,29	.730/18,54			
G	.970/24,64	.980/24,89			
H	.355/9,02	.365/9,27			
I	.004/0,10	.006/0,15			
J	.120/3,05	.130/3,30			

**RF & MICROWAVE TRANSISTORS**  
**800-900 MHz BASE STATION APPLICATIONS**

- 800 - 900 MHz
- 24 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- CLASS AB LINEAR OPERATION
- $P_{OUT} = 30$  W MIN. WITH 7.5 dB GAIN



**DESCRIPTION**

The SD1424 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in cellular base station application.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	48	V
$V_{CES}$	Collector-Emitter Voltage	45	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	5	A
$P_{DISS}$	Power Dissipation	43	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.0	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	48	50	—	V
$BV_{CEO}$	$I_C = 20mA$	$I_B = 0mA$	25	30	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	4.0	—	V
$I_{CBO}$	$V_{CB} = 24V$	$I_E = 0mA$	—	—	1.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	20	—	100	—

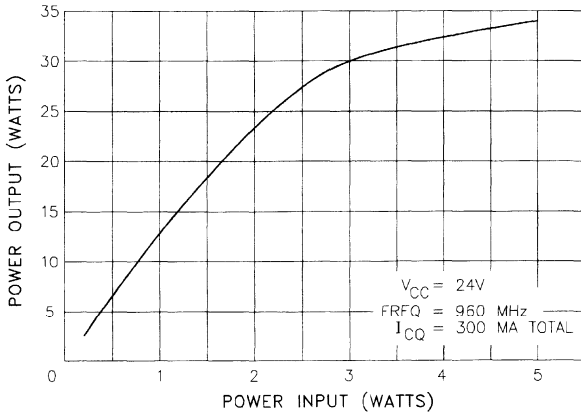
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 960\text{ MHz}$	$P_{IN} = 5.3\text{ W}$	$V_{CC} = 24\text{ V}$	30	—	—	W
GP	$f = 960\text{ MHz}$	$P_{IN} = 5.3\text{ W}$	$V_{CC} = 24\text{ V}$	7.5	—	—	dB
$\eta_c$	$f = 960\text{ MHz}$	$P_{IN} = 5.3\text{ W}$	$V_{CC} = 24\text{ V}$	45	50	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 24\text{ V}$		—	20	24	pF

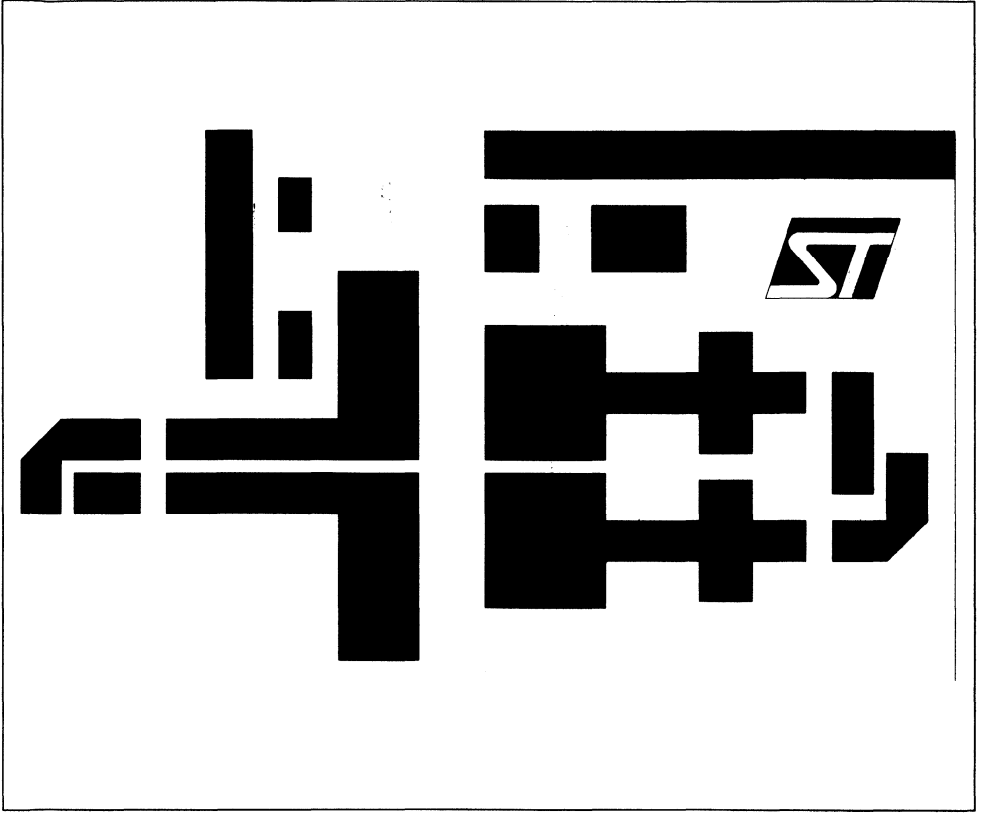
Note:  $I_{CQ} = 150mA$

**TYPICAL PERFORMANCE**

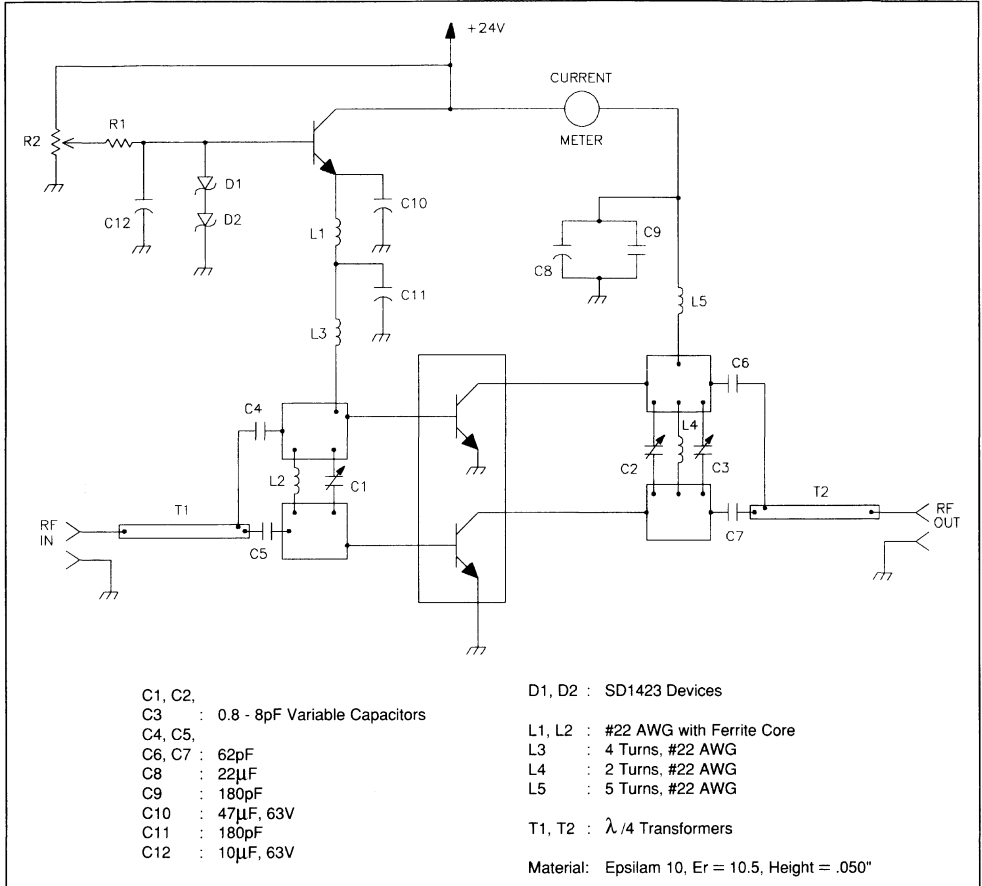
**POWER OUTPUT vs POWER INPUT**



TEST CIRCUIT LAYOUT

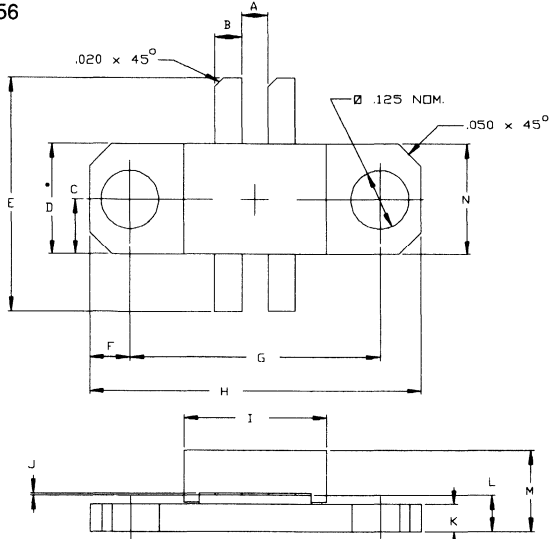


TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0156



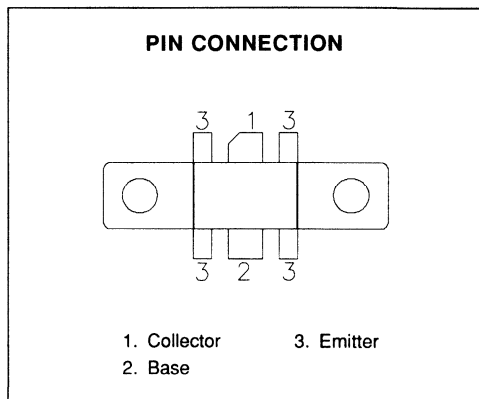
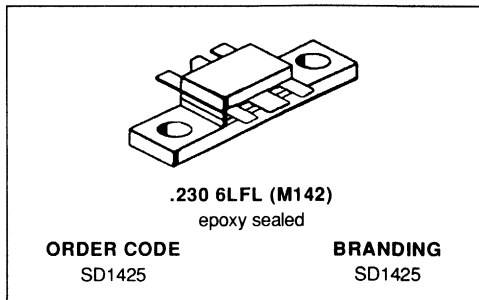
SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.060/1,52		K	.055/1,40	.065/1,65
B	.055/1,40	.065/1,65	L	.075/1,91	.095/2,41
C	.124/3,15		M		.190/4,83
D	.243/6,17	.253/6,43	N	.245/6,22	.257/6,53
E	635/16,13	665/16,89			
F	.092/2,34				
G	.555/14,10	.565/14,35			
H	.739/18,77	.749/19,02			
I	.315/8,00	.327/8,31			
J	.002/0,05	.006/0,15			





## RF & MICROWAVE TRANSISTORS 800-900 MHz BASE STATION APPLICATIONS

- 800 - 900 MHz
- 24 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- CLASS AB LINEAR OPERATION
- $P_{OUT} = 30 \text{ W MIN. WITH } 7.5 \text{ dB GAIN}$



### DESCRIPTION

The SD1425 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in cellular base station applications.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	50	V
$V_{CES}$	Collector-Emitter Voltage	45	V
$V_{EBO}$	Emitter-Base Voltage	5.0	V
$I_C$	Device Current	5.0	A
$P_{DISS}$	Power Dissipation	43	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**SD1425****ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

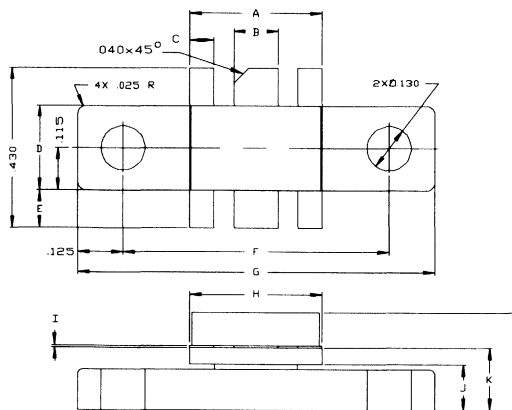
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{E}} = 0\text{mA}$		48	50	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 40\text{mA}$	$I_{\text{B}} = 0\text{mA}$		25	30	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$		3.5	5.0	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 24\text{V}$	$I_{\text{E}} = 0\text{mA}$		—	—	2.0	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 10\text{V}$	$I_{\text{C}} = 200\text{mA}$		20	—	100	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 5.3\text{ W}$	$V_{\text{CC}} = 24\text{ V}$	30	—	—	W
$G_{\text{P}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 5.3\text{ W}$	$V_{\text{CC}} = 24\text{ V}$	7.5	—	—	dB
$\eta_{\text{C}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 5.3\text{ W}$	$V_{\text{CC}} = 24\text{ V}$	45	50	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 24\text{ V}$		—	40	48	pF

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0142

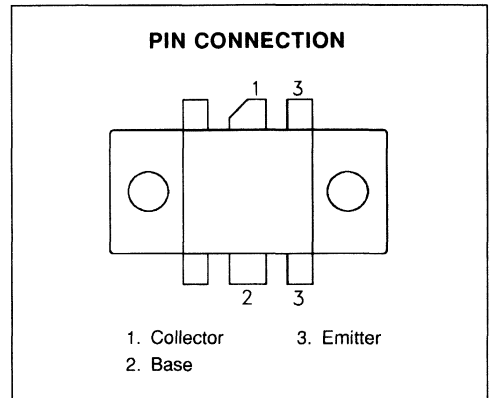
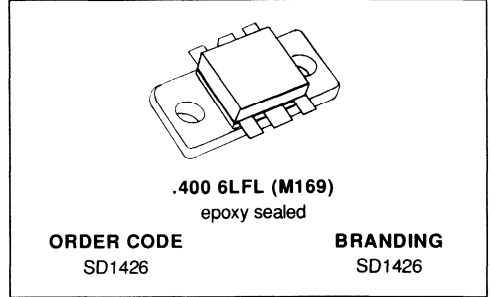


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.355/9,02	.365/9,27	K	.160/4,06	.180/4,57
B	.115/2,92	.125/3,18	L	.230/5,84	.260/6,60
C	.075/1,91	.085/2,16			
D	.225/5,72	.235/5,97			
E	.090/2,29	.110/2,79			
F	.720/18,29	.730/18,54			
G	.970/24,64	.980/24,89			
H	.355/9,02	.365/9,27			
I	.004/0,10	.006/0,15			
J	.120/3,05	.130/3,30			



**RF & MICROWAVE TRANSISTORS  
800/900 MHz APPLICATIONS**

- 900 MHz
- 24 VOLTS
- GOLD METALLIZATION
- EMITTER BALLASTED
- INTERNAL INPUT AND OUTPUT MATCHING
- COMMON BASE CONFIGURATION
- P<sub>OUT</sub> = 60 W MIN. WITH 7.0 dB GAIN



**DESCRIPTION**

The SD1426 is a 24 V epitaxial silicon NPN planar transistor designed primarily for common base amplifier applications in the 800 - 960 MHz frequency range.

**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	55	V
V <sub>CES</sub>	Collector-Emitter Voltage	55	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	10	A
P <sub>DISS</sub>	Power Dissipation	175	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	1.0	°C/W
----------------------	----------------------------------	-----	------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

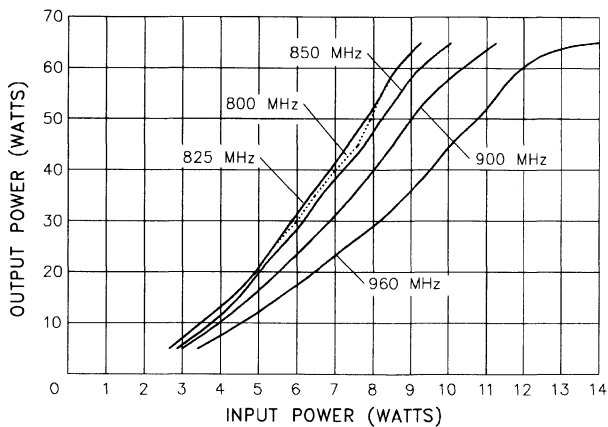
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{E}} = 0\text{mA}$	55	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 50\text{mA}$	$V_{\text{BE}} = 0\text{V}$	55	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$	28	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.0	—	—	V
$I_{\text{CES}}$	$V_{\text{CE}} = 25\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	10	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 2\text{A}$	20	—	150	—

## DYNAMIC

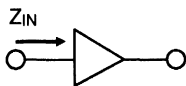
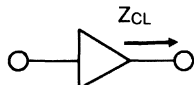
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 900\text{ MHz}$	$P_{\text{IN}} = 12\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	60	—	—	W
$G_{\text{P}}$	$f = 900\text{ MHz}$	$P_{\text{IN}} = 12\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	7.0	—	—	dB
$\eta_{\text{C}}$	$f = 900\text{ MHz}$	$P_{\text{IN}} = 12\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	55	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 24\text{ V}$		—	60	—	pF

## TYPICAL PERFORMANCE

BROADBAND POWER OUTPUT vs POWER INPUT

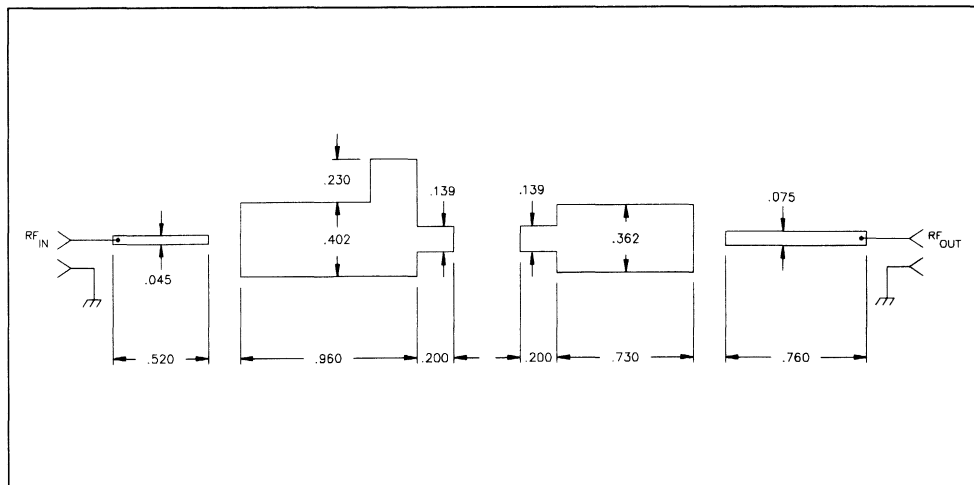


## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

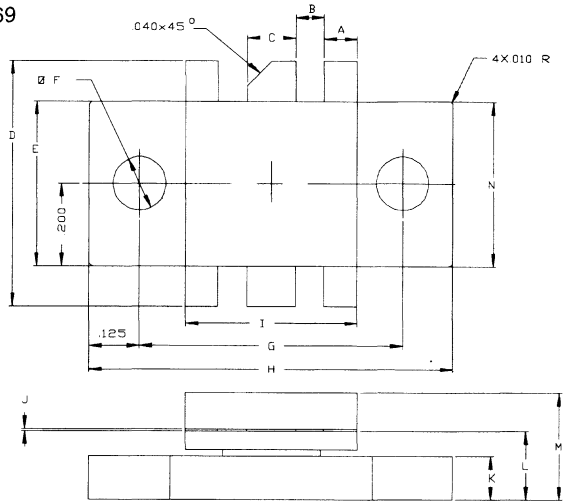
FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
960 MHz	$3.8 - j 3.8$	$4.9 + j 2.0$
930 MHz	$5.4 - j 4.8$	$4.6 + j 1.0$
900 MHz	$7.6 - j 3.4$	$5.0 + j 0.4$
870 MHz	$9.4 - j 2.6$	$4.3 + j 0.6$
850 MHz	$10.8 - j 2.4$	$4.4 + j 0.4$
800 MHz	$10.8 + j 1.0$	$4.3 + j 0.5$

## TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0169

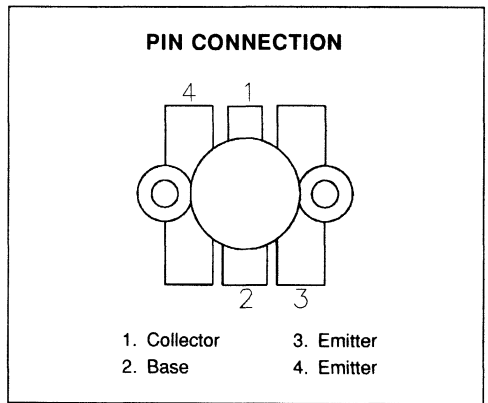
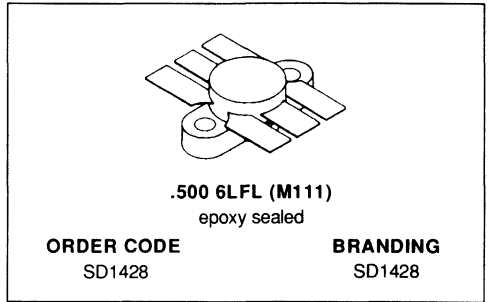


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.078/1,98	.088/2,24	K	105/2,67	.115/2,92
B	.120/3,05		L	159/4,04	.175/4,45
C	.115/2,92	.125/3,18	M		.280/7,11
D	.580/14,73	.620/15,75	N	.395/10,03	.408/10,36
E	.395/10,03	.405/10,29			
F	.125/3,18				
G	.720/18,29	.730/18,54			
H	.970/24,64	.980/24,89			
I	.420/10,67	.430/10,92			
J	.002/0,05	.007/0,18			



**RF & MICROWAVE TRANSISTORS  
VHF MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- EFFICIENCY 50%
- COMMON EMITTER
- GOLD METALLIZATION
- P<sub>OUT</sub> = 45 W MIN. WITH 6.5 dB GAIN


**DESCRIPTION**

The SD1428 is an internally matched 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications. This device utilizes diffused emitter resistors to achieve infinite VSWR through all phase angles at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	36	V
V <sub>CEO</sub>	Collector-Emitter Voltage	18	V
V <sub>CES</sub>	Collector-Emitter Voltage	36	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	6.0	A
P <sub>DISS</sub>	Power Dissipation	145	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	1.2	°C/W
----------------------	----------------------------------	-----	------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

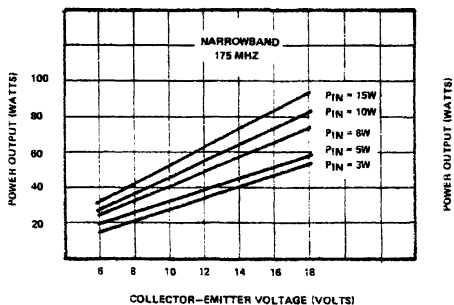
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	36	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 50mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 50mA	I <sub>B</sub> = 0mA	18	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 15V	I <sub>E</sub> = 0mA	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 5A	20	—	200	—

DYNAMIC

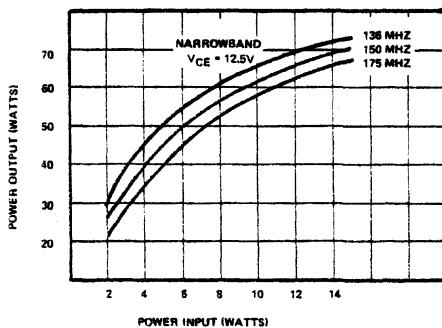
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 138 — 175 MHz	P <sub>IN</sub> = 10 W	V <sub>CE</sub> = 12.5 V	45	—	—	W
G <sub>p</sub>	f = 138 — 175 MHz	P <sub>IN</sub> = 10 W	V <sub>CE</sub> = 12.5 V	6.5	—	—	dB
η <sub>c</sub>	f = 138 — 175 MHz	P <sub>IN</sub> = 10 W	V <sub>CE</sub> = 12.5 V	50	—	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12.5 V		—	—	135	pF

TYPICAL PERFORMANCE

POWER OUTPUT vs COLLECTOR EMITTER VOLTAGE

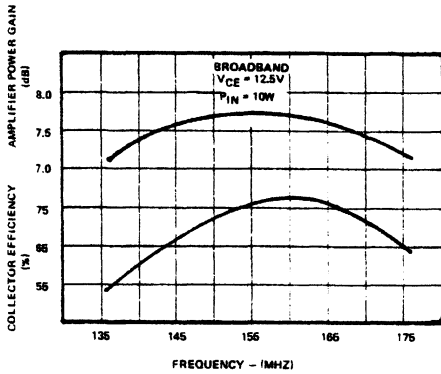


POWER OUTPUT vs POWER INPUT

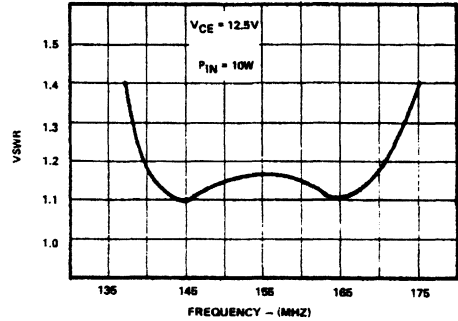


## TYPICAL PERFORMANCE (cont'd)

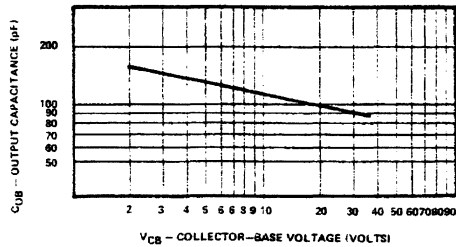
## POWER GAIN &amp; COLLECTOR EFFICIENCY vs FREQUENCY



## INPUT VSWR vs FREQUENCY

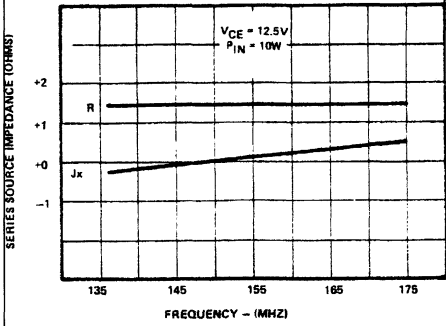


## COLLECTOR CAPACITANCE vs VOLTAGE

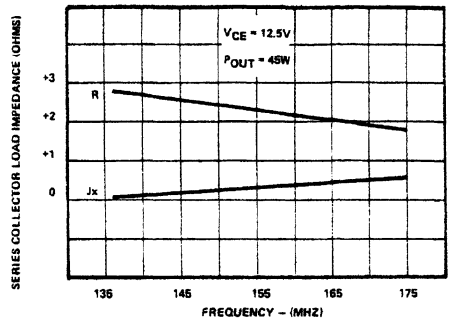


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



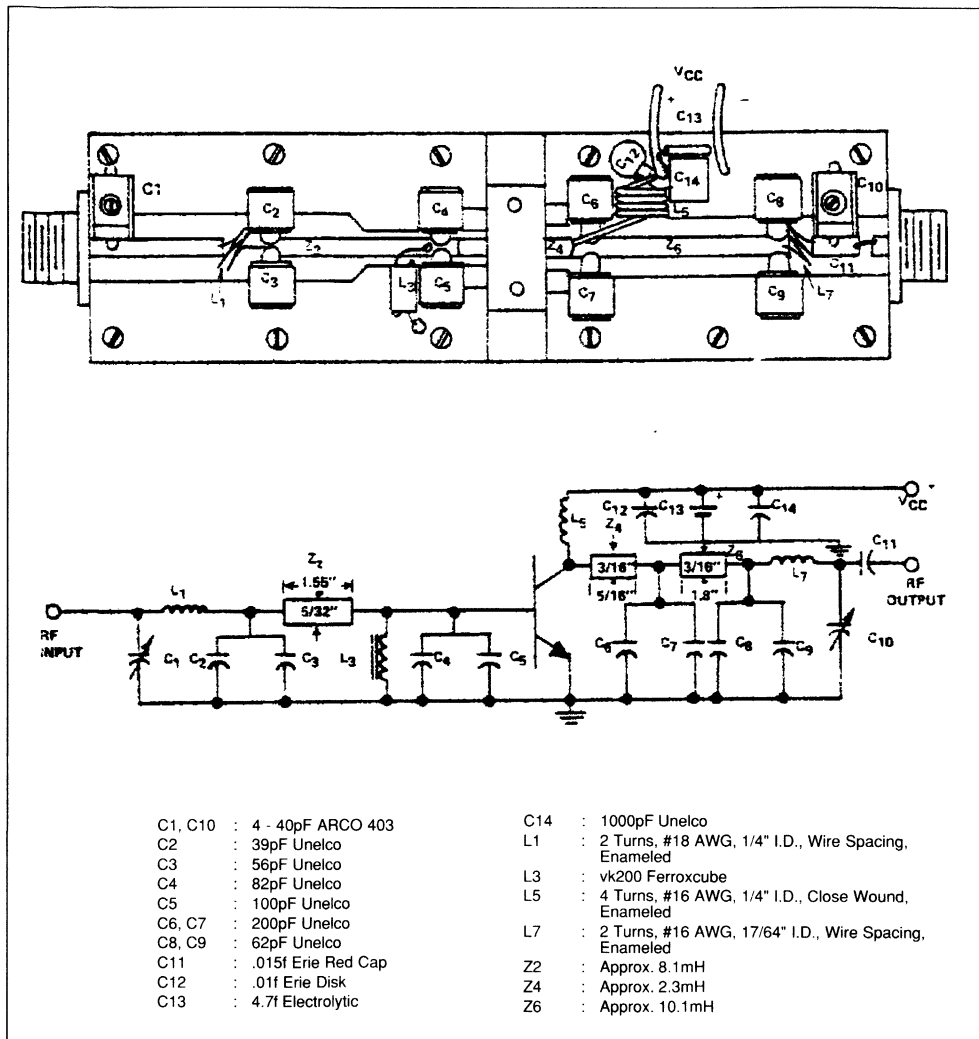
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
175 MHz	1.38 + j 0.44	1.70 + j 0.48

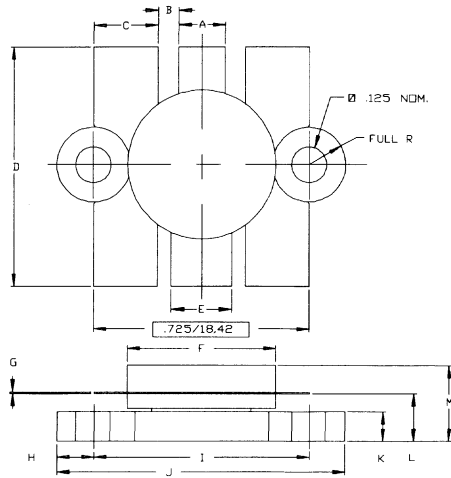
$P_{OUT} = 45W$   
 $P_{IN} = 10W$   
 $V_{CE} = 12.5V$

## TEST CIRCUIT



PACKAGE MECHANICAL DATA

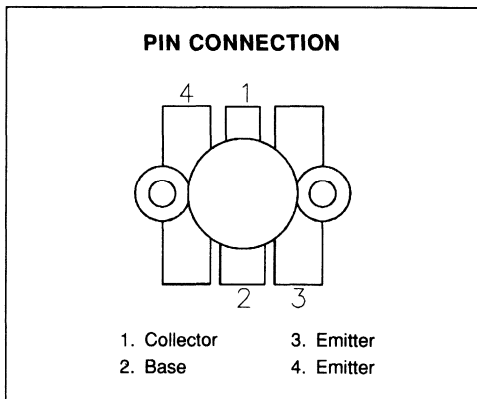
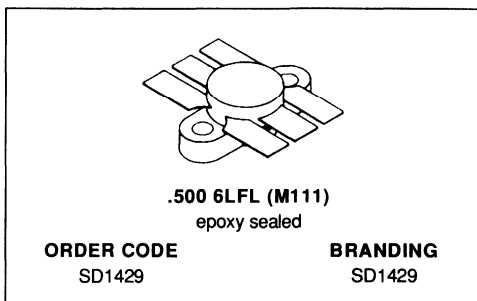
Ref.: Dwg. No.12-0111



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			

**RF & MICROWAVE TRANSISTORS**  
**UHF MOBILE APPLICATIONS**

- 470 MHz
- 12.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 12 \text{ W MIN. WITH } 7.8 \text{ dB GAIN}$


**DESCRIPTION**

The SD1429 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for UHF communications. This device utilizes "Tuned Q" technology which consists of an input matching network on the base to achieve optimum gain and broadband characteristics.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	16	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	3.4	A
$P_{DISS}$	Power Dissipation	37.5	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	4.6	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

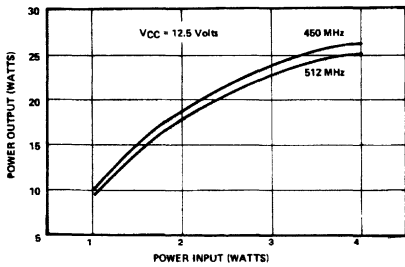
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 200mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 200mA$	$I_B = 0mA$	16	—	—	V
$BV_{EBO}$	$I_E = 4mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	2.0	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	20	—	200	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 470\text{ MHz}$	$P_{IN} = 2\text{ W}$	$V_{CE} = 12.5\text{ V}$	12	—	—	W
GP	$f = 470\text{ MHz}$	$P_{IN} = 2\text{ W}$	$V_{CE} = 12.5\text{ V}$	7.8	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 12\text{ V}$		—	—	50	pF

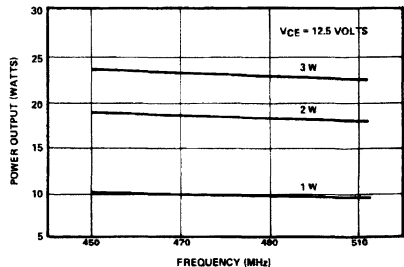
TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT



POWER OUTPUT VS POWER INPUT

POWER OUTPUT vs FREQUENCY

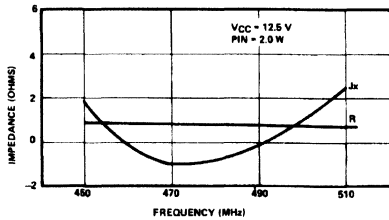


POWER OUTPUT VS FREQUENCY



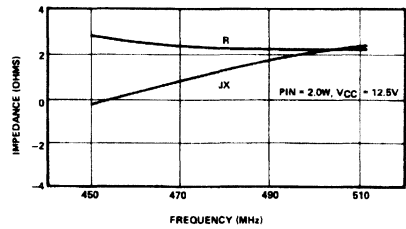
## IMPEDANCE DATA

## TYPICAL INPUT IMPEDANCE



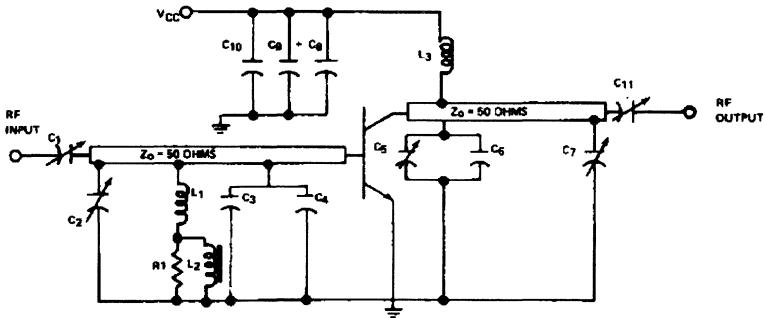
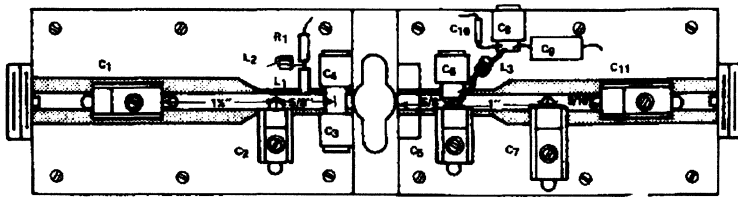
SOURCE IMPEDANCE VS FREQUENCY

## TYPICAL COLLECTOR LOAD IMPEDANCE



COLLECTOR LOAD IMPEDANCE VS FREQUENCY

## TEST CIRCUIT



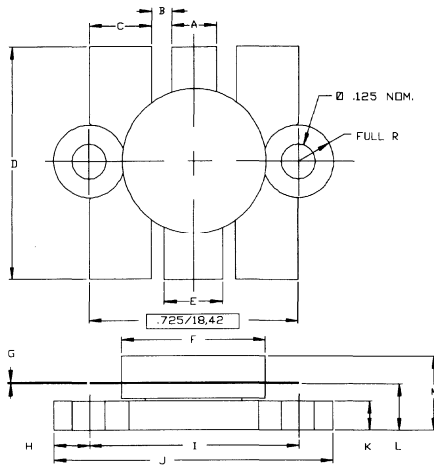
C1, C11 : 4 - 40pF, Arco 422  
 C2 : 0.9 - 7pF, Arco 400  
 C3, C4 : 20pF, Unelco  
 C5 : 1.5 - 20pF, Unelco  
 C6 : 15pF, Unelco  
 C7 : 2 - 25pF, Unelco  
 C8 : 1000pF, Unelco  
 C9 : 10μF, Electrolytic  
 C10 : 0.47μF, Erie Red Cap

L1 : 0.10μH, Molded Choke  
 L2 : 6 Turns, #28 AWG Thru Ferroxcube Sleeve #3B1  
 L3 : 6 Turns, #28 AWG, 0.20" I.D.  
 R1 : 56Ω, 1/4 Watt  
 Z0 : 50Ω Line

Board Material: Double Sided Copper 1/16" Thick, 2M-K-6098

PACKAGE MECHANICAL DATA

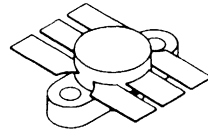
Ref.: Dwg. No.12-0111



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			

**RF & MICROWAVE TRANSISTORS  
 UHF MOBILE APPLICATIONS**

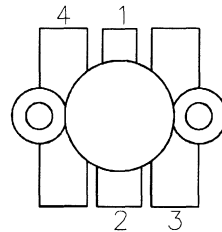
- 470 MHz
- 12.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 15\text{ W MIN. WITH } 7.5\text{ dB GAIN}$



**.500 6LFL (M111)**  
 epoxy sealed

**ORDER CODE**  
 SD1429-03

**BRANDING**  
 SD1429-3

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Emitter |

**DESCRIPTION**

The SD1429-03 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for UHF communications. It withstands infinite VSWR at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	16	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	3.4	A
$P_{DISS}$	Power Dissipation	37.5	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	4.6	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

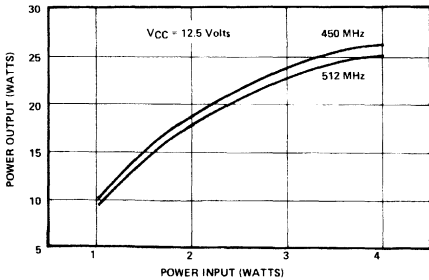
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	16	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CEO}$	$V_{CE} = 15V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 500mA$	20	—	200	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 470\text{ MHz}$	$P_{IN} = 2.5\text{ W}$	$V_{CC} = 12.5\text{ V}$	15	—	—	W
$G_P$	$f = 470\text{ MHz}$	$P_{IN} = 2.5\text{ W}$	$V_{CC} = 12.5\text{ V}$	7.5	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 12\text{ V}$		—	—	50	pF

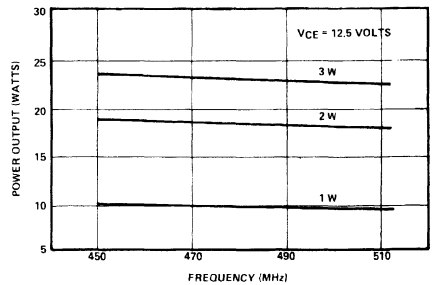
**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**



**POWER OUTPUT VS POWER INPUT**

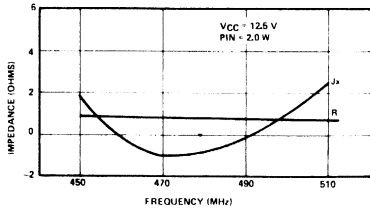
**POWER OUTPUT vs FREQUENCY**



**POWER OUTPUT VS FREQUENCY**

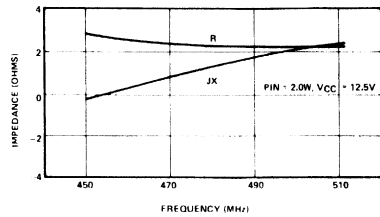
## IMPEDANCE DATA

### TYPICAL INPUT IMPEDANCE



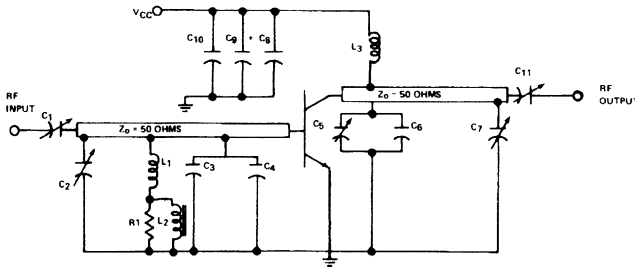
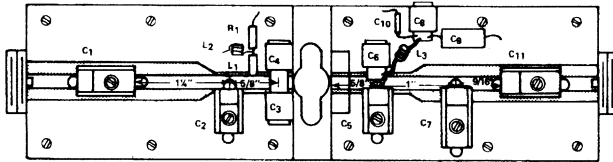
SOURCE IMPEDANCE VS FREQUENCY

### TYPICAL COLLECTOR LOAD IMPEDANCE



COLLECTOR LOAD IMPEDANCE VS FREQUENCY

## TEST CIRCUIT



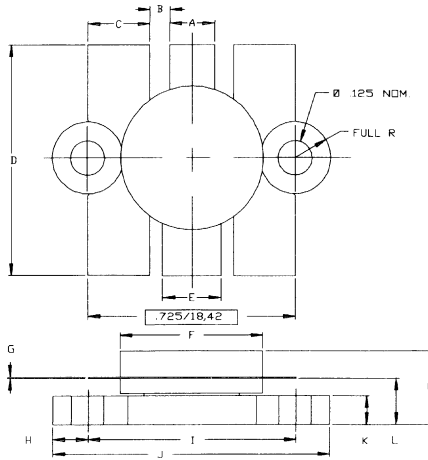
- C1, C11 : 4 - 4pF, Arco 422  
 C2 : 0.9 - 7pF, Arco 400  
 C3, C4 : 20pF, Unelco  
 C5 : 1.5 - 20pF, Arco  
 C6 : 15pF, Unelco  
 C7 : 2 - 25pF, Arco 421  
 C8 : 1000pF, Unelco  
 C9 : 10 $\mu$ F, Electrolytic, 30Vdc  
 C10 : 0.47 $\mu$ F, Erie Red Cap

- L1 : 0.10 $\mu$ H, Molded Choke  
 L2 : 6 Turns, #28 AWG Thru Ferroxcube Sleeve #3B1  
 L3 : 6 Turns, #20 AWG, 0.20" I.D.  
 R1 : 56 $\Omega$ , 1/4 Watt  
 Z0 : 50 $\Omega$  Line

Board Material: Double Sided Copper 1/16" Thick, 3M-K-6098  
 Mounted on 3/8" Brass Plates

PACKAGE MECHANICAL DATA

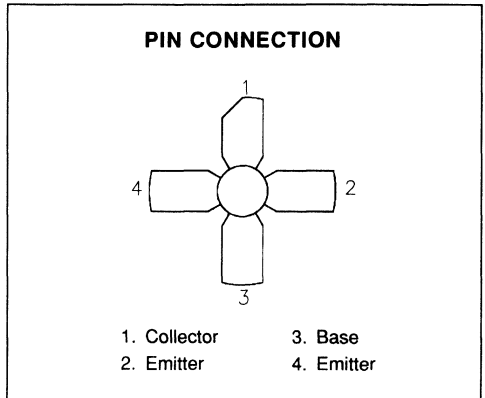
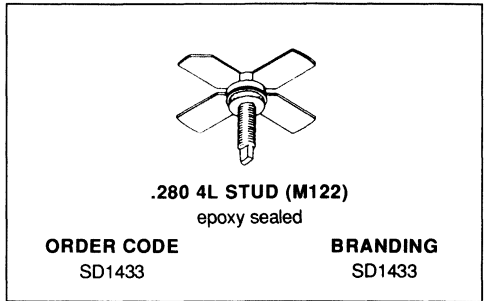
Ref.: Dwg. No.12-0111



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			

**RF & MICROWAVE TRANSISTORS  
UHF MOBILE APPLICATIONS**

- 470 MHz
- 12.5 VOLTS
- CLASS C
- EFFICIENCY 60%
- COMMON EMITTER
- $P_{OUT} = 10$  W MIN. WITH 8.0 dB GAIN


**DESCRIPTION**

The SD1433 is a Class C epitaxial silicon NPN planar transistor designed for driver applications in the 450 - 512 MHz frequency range. This device uses an emitter ballasted geometry specifically designed for optimum stable power gain, maximum efficiency and infinite VSWR.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	16	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	2.5	A
$P_{DISS}$	Power Dissipation	58	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.0	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

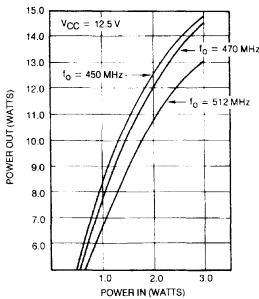
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 25mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 20mA	I <sub>B</sub> = 0mA	16	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 10V	I <sub>E</sub> = 0mA	—	—	3	mA
I <sub>CBO</sub>	V <sub>CB</sub> = 15V	I <sub>E</sub> = 0mA	—	—	2	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A	10	—	—	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 470 MHz	P <sub>IN</sub> = 2.0 W	V <sub>CE</sub> = 12.5 V	10	—	—	W
G <sub>P</sub>	f = 470 MHz	P <sub>OUT</sub> = 10 W	V <sub>CE</sub> = 12.5 V	7	—	—	dB
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12.5 V		—	19	—	pF

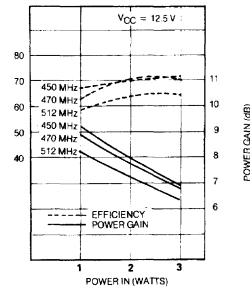
TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT



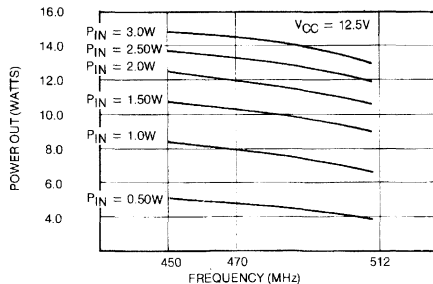
POWER OUT VS POWER IN

POWER GAIN & EFFICIENCY vs POWER INPUT



POWER GAIN/EFFICIENCY vs POWER IN

POWER OUTPUT vs FREQUENCY

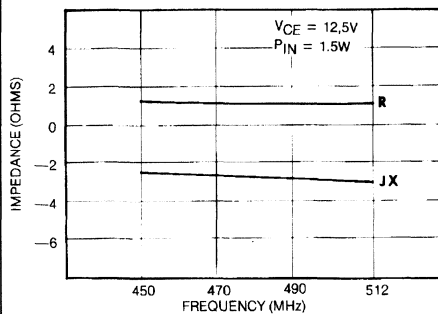


POWER OUT VS FREQUENCY

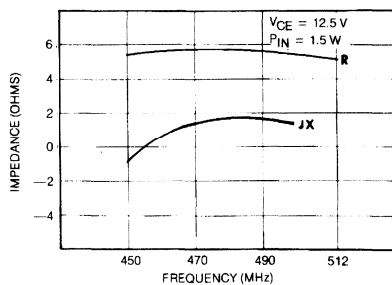


## IMPEDANCE DATA

## TYPICAL INPUT IMPEDANCE



## TYPICAL COLLECTOR LOAD IMPEDANCE

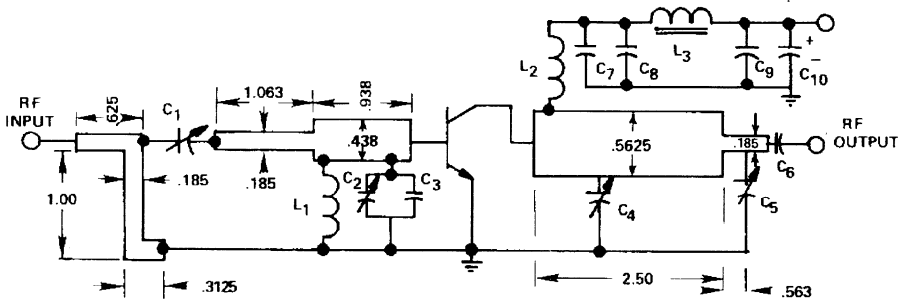
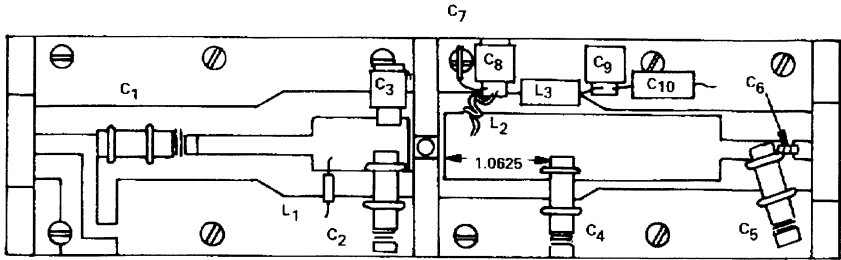


## SERIES COLLECTOR LOAD IMPEDANCE VS FREQUENCY

## SERIES SOURCE IMPEDANCE VS FREQUENCY

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
470 MHz	1.5 - j 2.7	5.7 + j 1.5

TEST CIRCUIT



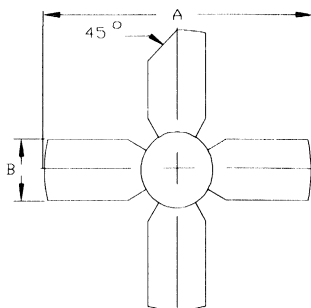
- C1, C2 : 0.8pF Voltronics
- C3 : 18pF Chip Capacitor
- C4, C5 : AJ810
- C6 : 1000pF Chip Capacitor
- C7 : 0.01μF Disc Ceramic
- C8, C9 : 1000pF Unelco
- C10 : 10μF, 35V Electrolytic

- L1 : 0.47μH Molded Choke
- L2 : 2 Turns, #20 AWG, 1/8" I.D.
- L3 : 2 Turns in Ferroxcube VK200/19-4B

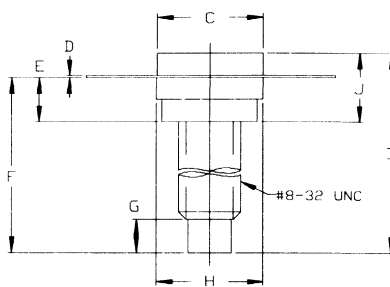
Board  
Material: 3M-K6098, 1/16" Thick

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0122



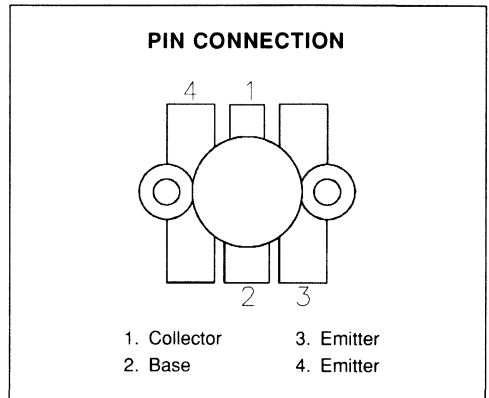
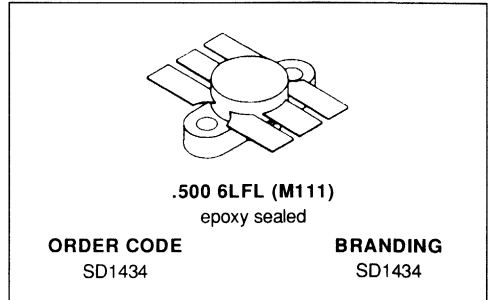
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51





**RF & MICROWAVE TRANSISTORS  
UHF MOBILE APPLICATIONS**

- 470 MHz
- 12.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 45 \text{ W MIN. WITH } 5.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1434 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for UHF communications. This device utilizes diffused emitter resistors to achieve infinite VSWR under operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	16	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	10.0	A
$P_{DISS}$	Power Dissipation	175	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

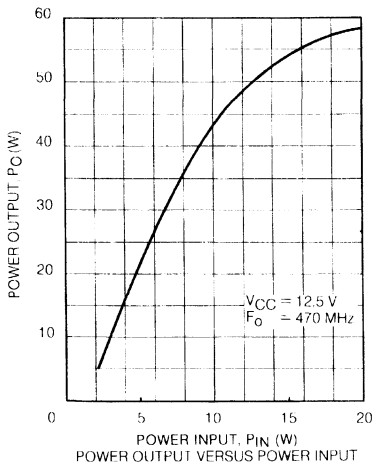
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	36	—	—	V
$BV_{CES}$	$I_C = 20mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	16	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 22V$	$I_E = 0mA$	—	—	5	mA
$I_{CBO}$	$V_{CB} = 15V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	20	—	200	—

DYNAMIC

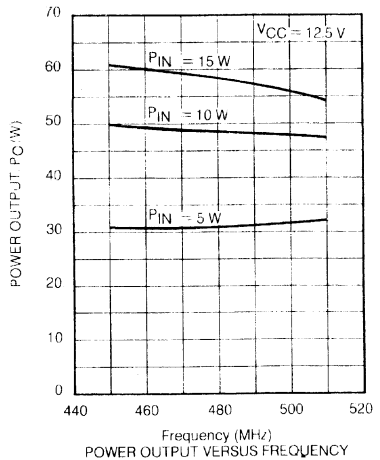
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 470\text{ MHz}$	$P_{IN} = 14\text{ W}$	$V_{CE} = 12.5\text{ V}$	45	—	—	W
$G_P$	$f = 470\text{ MHz}$	$P_{IN} = 14\text{ W}$	$V_{CE} = 12.5\text{ V}$	5	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 12.5\text{ V}$		—	130	—	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

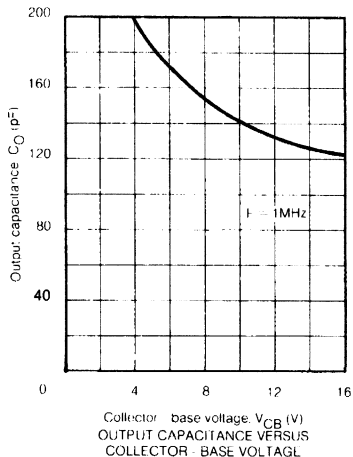


**POWER OUTPUT vs FREQUENCY**



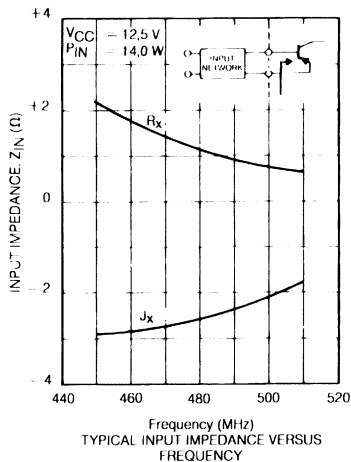
TYPICAL PERFORMANCE (cont'd)

OUTPUT CAPACITANCE vs COLLECTOR BASE VOLTAGE

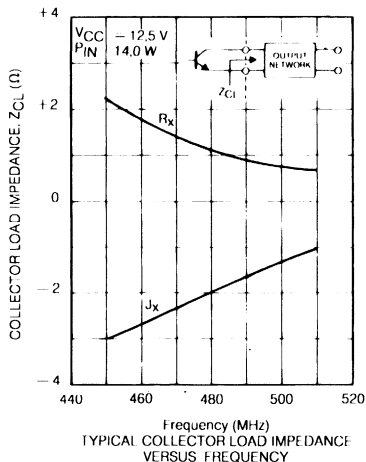


IMPEDANCE DATA

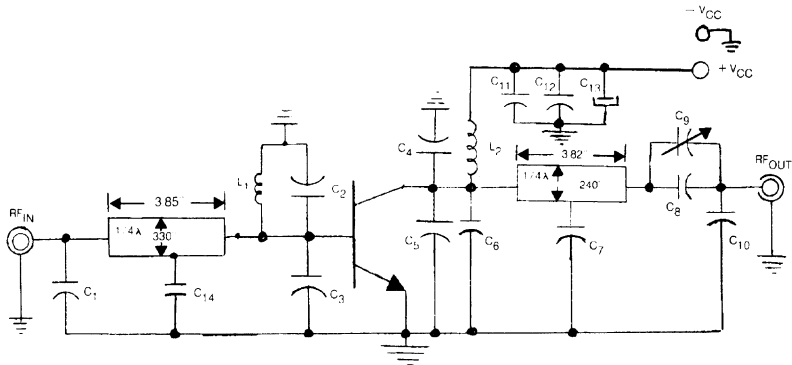
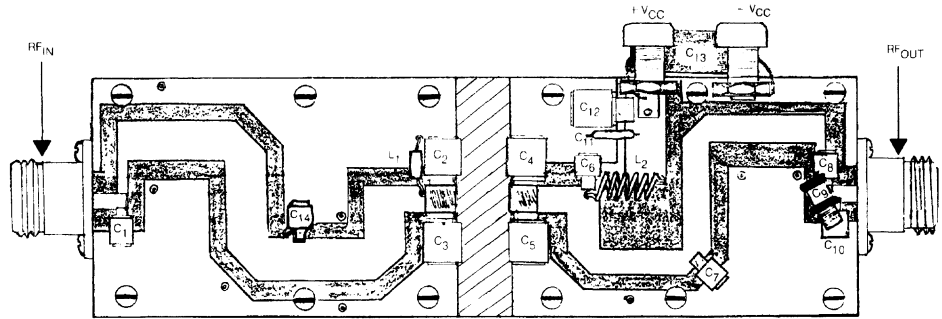
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



TEST CIRCUIT



- C1 : 10pF Unelco, 200 mil Sq.
- C2 : 36pF Unelco, 400 mil Sq.
- C3 : 34pF Unelco, 400 mil Sq.
- C4 : 36pF Unelco, 400 mil Sq.
- C5 : 38pF Unelco, 400 mil Sq.
- C6 : 16pF Unelco, 200 mil Sq.
- C7 : 10pF Unelco, 200 mil Sq.
- C8 : 25pF Unelco, 200 mil Sq.
- C9 : 1 - 12pF, ATC Variable
- C10 : 6pF Unelco, 200 mil Sq.

- C11 : .01μF 50V, Erie Disc
- C12 : 1000pF Unelco, 400 mil Sq.
- C13 : 47μF 63V, Sprague Electrolytic
- C14 : 10pF Unelco, 200 mil Sq.

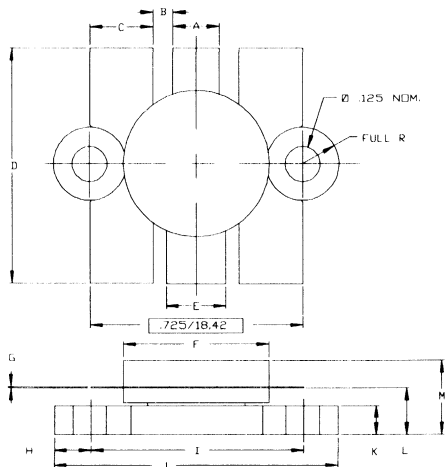
- L1 : 27μH Molded
- L2 : 6 Turns, #18 AWG, .175" I.D.

Material : Pc Board, Double Sided Copper 1/32" Thick  
Teflon-Glass, 3M-K-6098



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0111

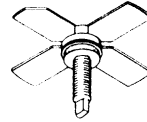


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M	.280/7,11	
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			



**RF & MICROWAVE TRANSISTORS**  
**UHF TV/LINEAR APPLICATIONS**

- 860 MHz
- COMMON EMITTER
- GOLD METALLIZATION
- CLASS A LINEAR OPERATION
- $P_{OUT} = 2$  W MIN. WITH 8.5 dB GAIN



**.280 4L STUD (M122)**  
epoxy sealed

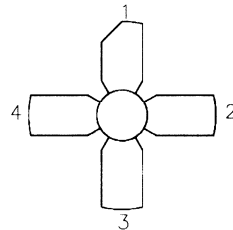
**ORDER CODE**  
SD1437

**BRANDING**  
TCC593

**DESCRIPTION**

The SD1437 is a silicon NPN bipolar device specifically designed for high linearity applications in the UHF frequency range including TV Bands IV and V.

Gold metallization and emitter ballasting assure high reliability under Class A linear amplifier operation.

**PIN CONNECTION**


1. Collector                      3. Base  
 2. Emitter                        4. Emitter

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	25	V
$V_{EBO}$	Emitter-Base Voltage	4	V
$I_C$	Device Current	800	mA
$P_{DISS}$	Power Dissipation	15.9	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	11.0	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

# SD1437

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 10mA	I <sub>E</sub> = 0mA	45	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 80mA	I <sub>B</sub> = 0mA	25	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CBO</sub>	V <sub>CB</sub> = 28V	I <sub>E</sub> = 0mA	—	—	0.45	mA
h <sub>FE</sub>	V <sub>CE</sub> = 20V	I <sub>C</sub> = 250mA	10	—	100	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub> <sup>1</sup>	f = 860 MHz	V <sub>CE</sub> = 25 V	I <sub>C</sub> = 450 mA	2	—	—	W
G <sub>P</sub> <sup>2</sup>	f = 860 MHz	V <sub>CE</sub> = 25 V	I <sub>C</sub> = 450 mA	8.5	—	—	dB
IMD <sub>3</sub> <sup>3</sup>	P <sub>SYNC</sub> = 2 W	V <sub>CE</sub> = 25 V	I <sub>C</sub> = 450 mA	—	-60	—	dBc
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 25 V		—	—	10	pF

Note 1: P<sub>IN</sub> = 0.3 W

Note 2: P<sub>OUT</sub> = 2 W

Note 3: Levels relative to P<sub>SYNC</sub>

f<sub>1</sub> = 860.0 MHz -8dBc

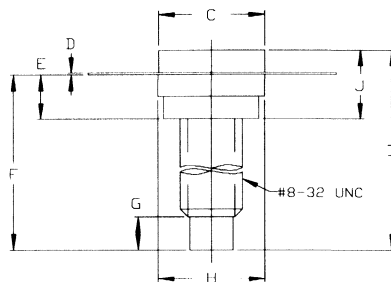
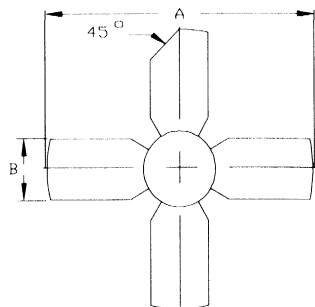
f<sub>1</sub> = 863.5 MHz -16dBc

f<sub>1</sub> = 864.5 MHz -7dBc

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0122

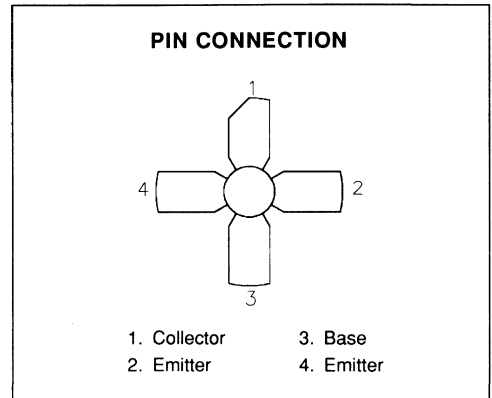
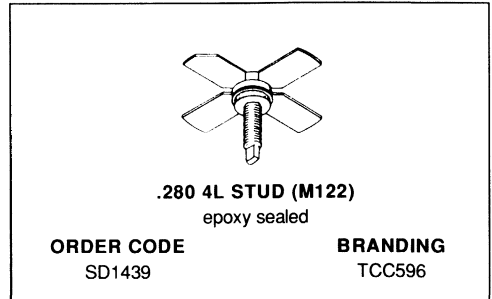
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51





**RF & MICROWAVE TRANSISTORS**  
**UHF TV\LINEAR APPLICATIONS**

- 860 MHz
- COMMON EMITTER
- GOLD METALLIZATION
- CLASS A LINEAR OPERATION
- $P_{OUT} = 0.5 \text{ W MIN. WITH } 9.5 \text{ dB GAIN}$


**DESCRIPTION**

The SD1439 is a silicon NPN bipolar device specifically designed for high linearity applications in the UHF frequency range including TV Bands IV and V.

Gold metallization and emitter ballasting assure high reliability under Class A linear amplifier operation.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	25	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	31.8	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{CEO}$	$I_C = 20mA$	$I_B = 0mA$	24	—	—	V
$BV_{EBO}$	$I_E = 0.25mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{CB} = 28V$	$I_E = 0mA$	—	—	0.45	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	120	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}^1$	$f = 860 MHz$	$V_{CE} = 20 V$	$I_C = 220 mA$	0.5	—	—	W
$G_P^2$	$f = 860 MHz$	$V_{CE} = 20 V$	$I_C = 220 mA$	9.5	—	—	dB
$IMD_3^3$	$P_{SYNC} = 0.5 W$	$V_{CE} = 20 V$	$I_C = 220 mA$	—	—	-58	dBc
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	—	5	pF

Note:  $P_{IN} = 56 mW$

Note 2:  $P_{OUT} = 0.5 W$

Note 3: Levels relative to  $P_{SYNC} = 0.5 W$

$f_1 = 860.0 MHz$  -8dBc

$f_2 = 863.5 MHz$  -16dBc

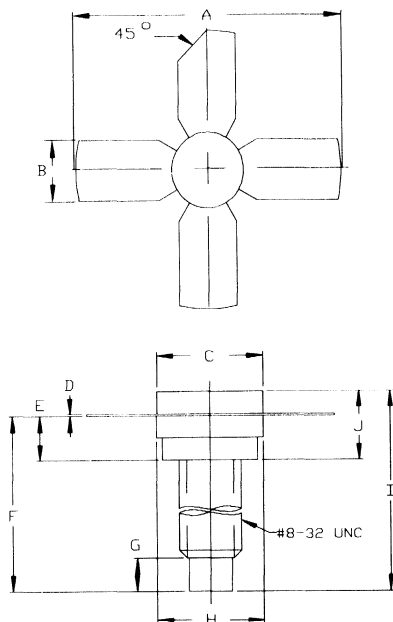
$f_3 = 864.5 MHz$  -7dBc



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0122

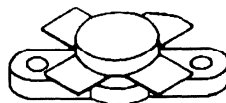
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51





**RF & MICROWAVE TRANSISTORS  
HF/VHF APPLICATIONS**

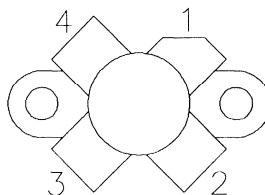
- 50 MHz
- 12.5 VOLTS
- EFFICIENCY 55%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 70 \text{ W MIN. WITH } 10 \text{ dB GAIN}$



**.380 4LFL (M113)**  
epoxy sealed

**ORDER CODE**  
SD1446

**BRANDING**  
SD1446

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

**DESCRIPTION**

The SD1446 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for land mobile transmitter applications. This device utilizes emitter ballasting and is extremely stable and capable of withstanding high VSWR under operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	12.0	A
$P_{DISS}$	Power Dissipation	183	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.05	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

# SD1446

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

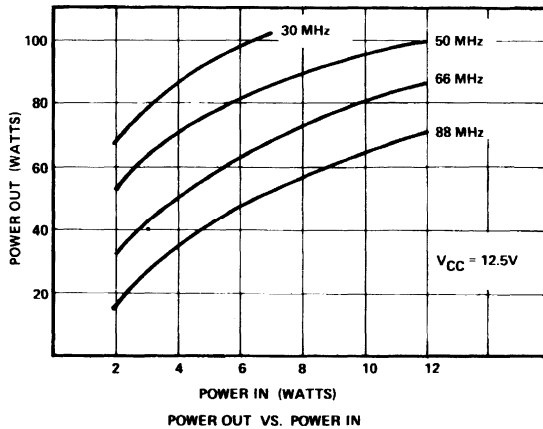
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	36	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 100mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 50mA	I <sub>B</sub> = 0mA	18	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 15V	I <sub>E</sub> = 0mA	—	—	10	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 5A	10	—	—	—

### DYNAMIC

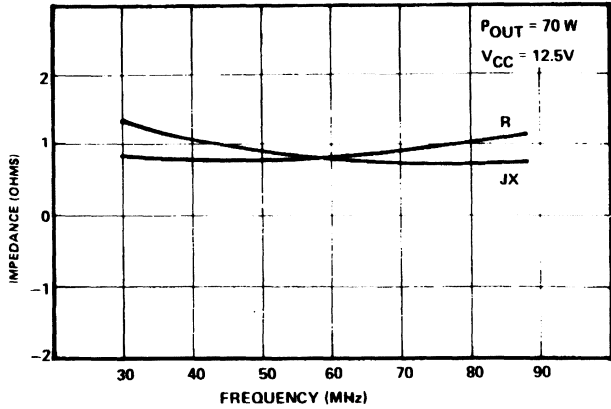
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 50 MHz	P <sub>IN</sub> = 7 W	V <sub>CE</sub> = 12.5 V	70	—	—	W
G <sub>P</sub>	f = 50 MHz	P <sub>IN</sub> = 7 W	V <sub>CE</sub> = 12.5 V	10	—	—	dB
η <sub>c</sub>	f = 50 MHz	P <sub>IN</sub> = 7 W	V <sub>CE</sub> = 12.5 V	—	55	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12.5V		—	—	300	pF

### TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT



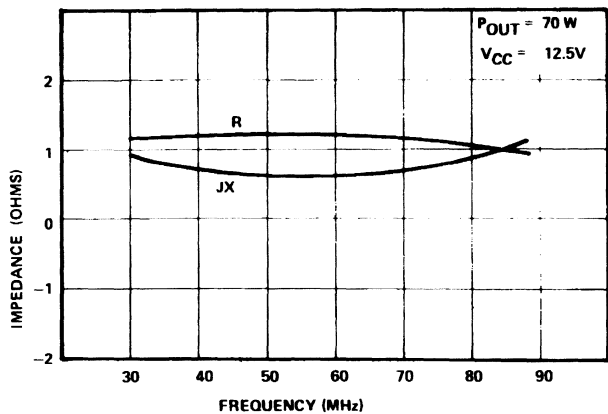
## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCE

SERIES SOURCE IMPEDANCE

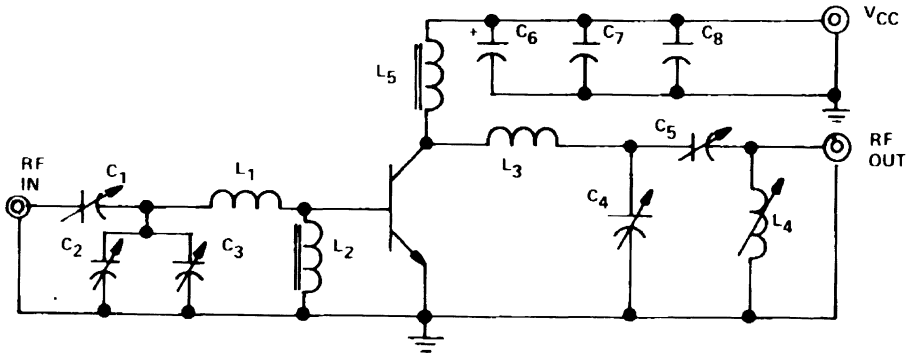
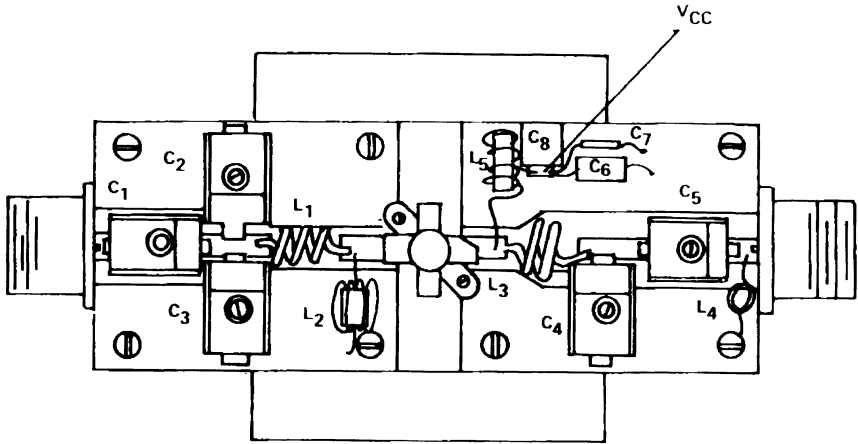
FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
50 MHz	$0.8 + j 0.9$	$1.2 + j 0.6$

$P_{OUT} = 70\text{ W}$   
 $V_{CE} = 12.5\text{ V}$

TYPICAL COLLECTOR  
LOAD IMPEDANCE

SERIES COLLECTOR LOAD IMPEDANCE

## TEST CIRCUIT



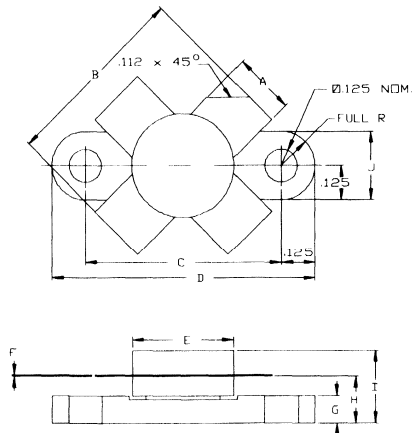
- C1, C4 : 50 - 380pF Arco 465  
 C2 : 110 - 580pF Arco 467  
 C3 : 140 - 680pF Arco 468  
 C5 : 9 - 180pF Arco 463  
 C6 : 10 $\mu$ F, 35Vdc, Electrolytic  
 C7 : .01 $\mu$ F Erie  
 C8 : 1000pF Unelco  
  
 L1 : 2 1/2 Turns, #14 Awg, Tinned, 1/4" I.D.  
 Loose Wound

- L2 : 10 Turns, #28 AWG, Enameled on  
 Ferroxcube Sleeve #3B  
 L3 : 1 1/2 Turns, #12 AWG, Tinned, 3/8" I.D.  
 Loose Wound  
 L4 : 8 Turns, #18 AWG on 1/4" I.D. Coil form 1/2"  
 Length with Ferrite Slug  
 L5 : 11 Turns, #16 AWG, Enameled on Torroid,  
 Micrometals, T50-2

Board Material: Double Sided Copper 1/16" Thick

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0113



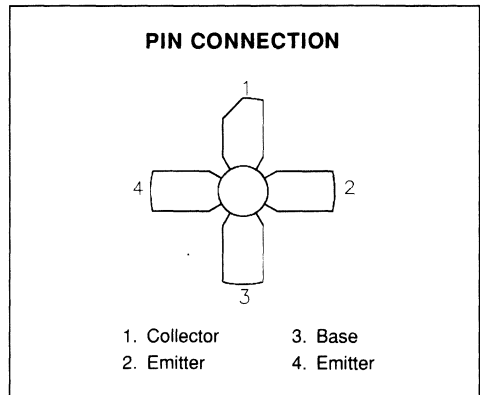
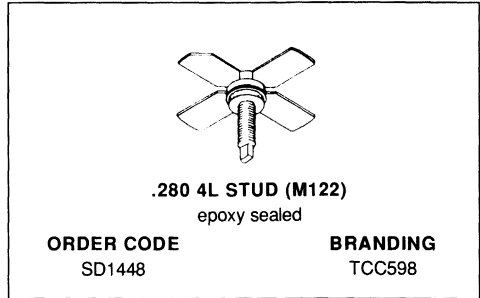
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.785/19,94	
C	.720/18,29	.730/18,54
D	.970/24,64	.980/24,89
E		.385/9,78
F	.004/0,10	.006/0,15
G	.085/2,16	.105/2,67
H	.160/4,06	.180/4,57
I		.280/7,11
J	.240/6,10	.255/6,48





**RF & MICROWAVE TRANSISTORS  
 UHF TV/LINEAR APPLICATIONS**

- 860 MHz
- 25 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- CLASS A LINEAR OPERATION
- $P_{OUT} = 4.0 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1448 is a silicon NPN bipolar device specifically designed for high linearity applications in the UHF frequency range including TV Bands IV and V.

Gold metallization and emitter ballasting assure high reliability under Class A linear amplifier operation.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	25	V
$V_{EBO}$	Emitter-Base Voltage	4	V
$I_C$	Device Current	1.6	A
$P_{DISS}$	Power Dissipation	31.8	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**SD1448 (TCC598)****ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 10\text{mA}$	$I_{\text{E}} = 0\text{mA}$	45	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 20\text{mA}$	$I_{\text{B}} = 0\text{mA}$	25	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 2.5\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.0	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 28\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	0.9	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 20\text{V}$	$I_{\text{C}} = 500\text{mA}$	10	—	—	—

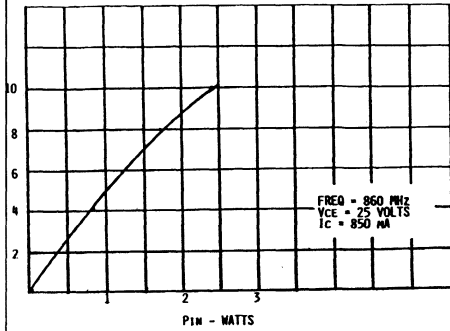
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}^1$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$I_{\text{C}} = 850\text{ mA}$	4.0	—	—	W
$G_{\text{P}}^2$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$I_{\text{C}} = 850\text{ mA}$	7.0	—	—	dB
$\text{IMD}_3^3$	$P_{\text{SYNC}} = 4\text{ W}$	$V_{\text{CE}} = 25\text{ V}$	$I_{\text{C}} = 850\text{ mA}$	—	—	-60	dBc
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 25\text{ V}$		—	—	20	pF

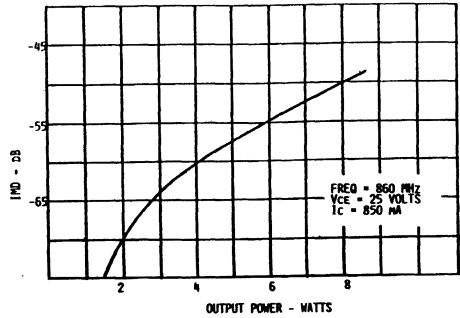
Note 1:  $P_{\text{IN}} = 0.8\text{W}$ Note 2:  $P_{\text{OUT}} = 4\text{ W}$ Note 3: Levels relative to  $P_{\text{SYNC}} = 4\text{ W}$  $f_1 = 860.0\text{ MHz}$  -8dBc $f_2 = 863.5\text{ MHz}$  -16dBc $f_3 = 864.5\text{ MHz}$  -7dBc

## TYPICAL PERFORMANCE

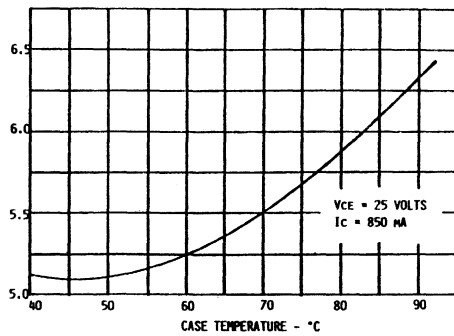
POWER OUTPUT vs POWER INPUT



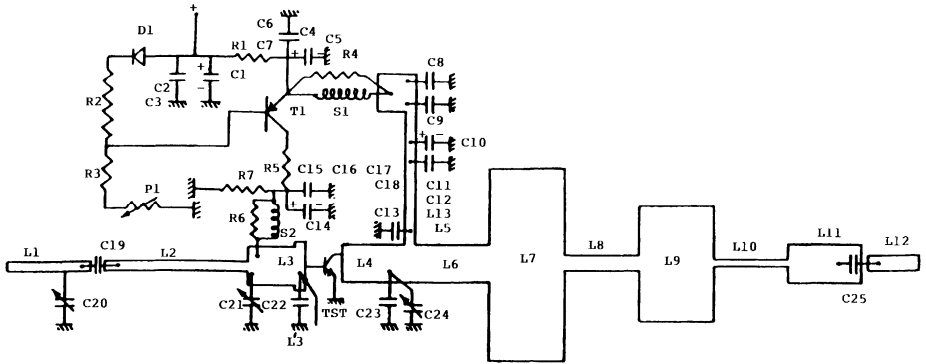
INTERMODULATION DISTORTION vs POWER OUTPUT



THERMAL RESISTANCE vs CASE TEMPERATURE

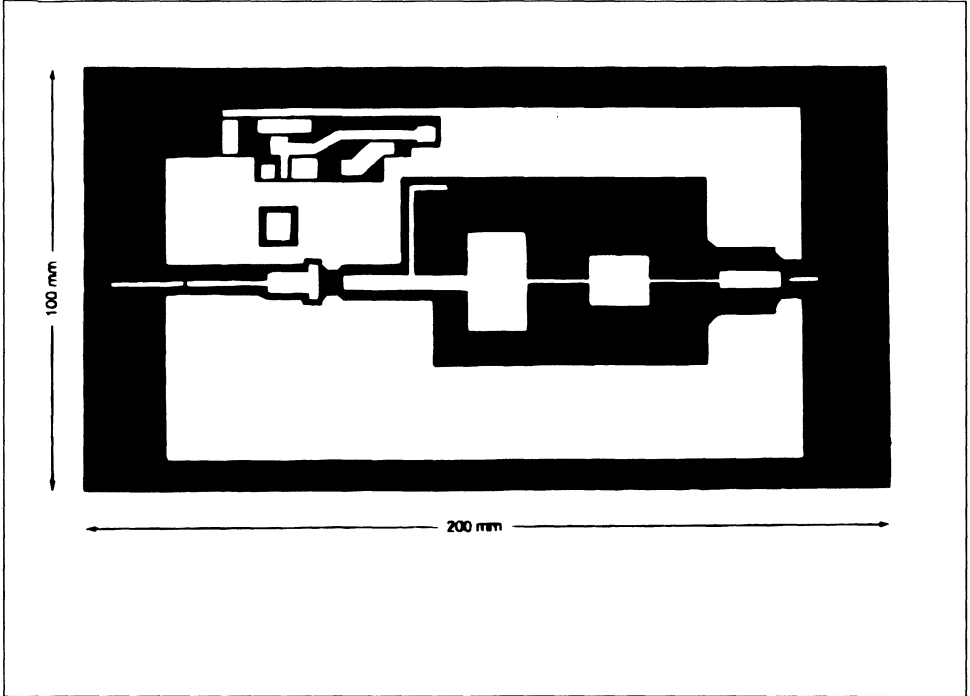


## TEST CIRCUIT



C1	: 22mF, 63V Sprague	L7	: 4Ω Transmission Line, Length 8% λ at 860 MHz
C2, C6,		L8	: 55Ω Transmission Line, Length 7.5% λ at 860 MHz
C8, C15	: 4.7nF Chip LCC	L9	: 7.5Ω Transmission Line, Length 8% λ at 860 MHz
C3, C7, C9,		L10	: 100Ω Transmission Line, Length 8% λ at 860 MHz
C11, C16	: 100nF Chip LCC	L11	: 20Ω Transmission Line, Length 8% λ at 860 MHz
C4, C10	: 4.7μF, 40V Sprague	L12	: 50Ω Transmission Line, Length 5mm
C5, C15	: 4.7μF, 63V Sprague	L13	: 50Ω Transmission Line, Length 12mm
C12, C17,		P1	: 3.3kΩ Adjustable
C18	: 470pF Chip LCC	R1	: 2.2Ω, 3W SFERNICE
C13, C25	: 47pF ATC 100B	R2	: 100Ω, 1/2W
C19	: 47pF ATC 100A	R3	: 51Ω, 1/2W
C20	: 0.5 - 4.5pF Adjustable Airtronic	R4, R6	: 100Ω, 1/2W
C21, C24	: 0.8 - 5pF Adjustable Johanson	R5, R7	: 56Ω, 1W
C22	: 10pF ATC 100A	T1	: BDX 54 B
C23	: 15pF ATC 100B	S1	: 6 Turns, Wire Diameter 0.5mm on 2.5mm Internal Diameter
D1	: 1N 4001 or 1N 914	S2	: 10 to 12 Turns on R6, Wire Diameter 0.5mm
L1	: 50Ω Transmission Line, Length 18mm	PC Board	
L2	: 50Ω Transmission Line, Length 22mm	Material	: Er = 2.5, .020" Thick
L3	: 16.4Ω Transmission Line, Length 12mm		
L'3	: 10.5Ω Transmission Line, Length 3.5mm		
L4	: 20Ω Transmission Line, Length 13mm		
L5	: 50Ω Transmission Line, Length 2.5mm		
L6	: 20Ω Transmission Line, Length 23mm		

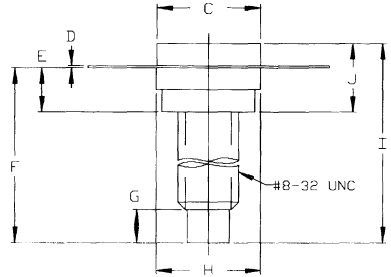
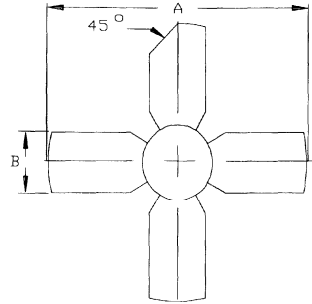
## TEST CIRCUIT LAYOUT



PACKAGE MECHANICAL DATA

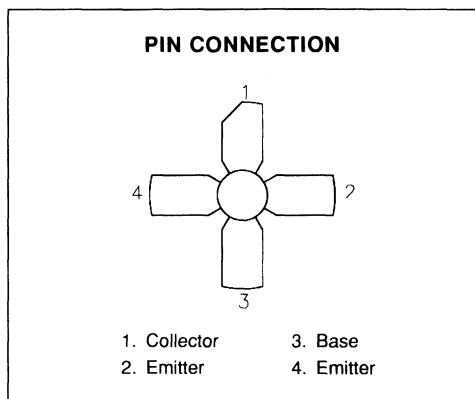
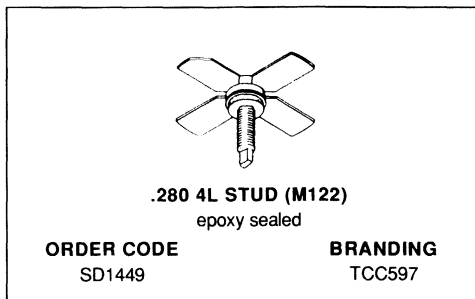
Ref.: Dwg. No.12-0122

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51



**RF & MICROWAVE TRANSISTORS  
 UHF TV LINEAR APPLICATIONS**

- 860 MHz
- 20 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- CLASS A LINEAR OPERATION
- $P_{OUT} = 1.0$  W MIN. WITH 10.0 dB GAIN


**DESCRIPTION**

The SD1449 is a silicon NPN bipolar device specifically designed for high linearity applications in the UHF frequency range including TV Bands IV and V.

Gold metallization and emitter ballasting assure high reliability under Class A linear amplifier operation.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	25	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	1.2	A
$P_{DISS}$	Power Dissipation	19.4	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	9.0	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 2mA$	$I_E = 0mA$	45	—	—	V
$BV_{CER}$	$I_C = 40mA$	$R_{BE} = 10\Omega$	50	—	—	V
$BV_{CEO}$	$I_C = 40mA$	$I_B = 0mA$	24	—	—	V
$BV_{EBO}$	$I_E = .5mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{CB} = 28V$	$I_E = 0mA$	—	—	0.45	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 200mA$	20	—	120	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}^1$	$f = 860 MHz$	$V_{CE} = 20 V$	$I_C = 440 mA$	1	—	—	W
$G_p^2$	$f = 860 MHz$	$V_{CE} = 20 V$	$I_C = 440 mA$	10	—	—	dB
$IMD_3^3$	$P_{SYNC} = 1 W$	$V_{CE} = 20 V$	$I_C = 440 mA$	—	—	-58	dBc
$IMD_3^3$	$P_{SYNC} = 2 W$	$V_{CE} = 20 V$	$I_C = 440 mA$	—	—	-51	dBc
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 20V$		—	—	7	pF

Note 1:  $P_{IN} = 0.1W$

Note 2:  $P_{OUT} = 1 W$

Note 3: Levels relative to  $P_{SYNC}$

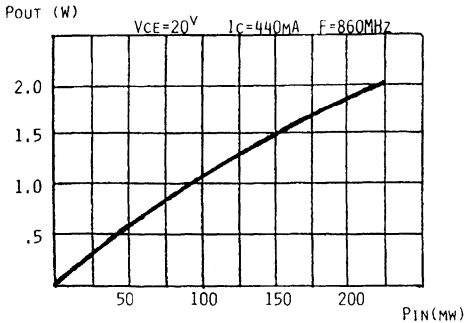
$f_1 = 860.0 MHz$  -8dBc

$f_2 = 863.5 MHz$  -16dBc

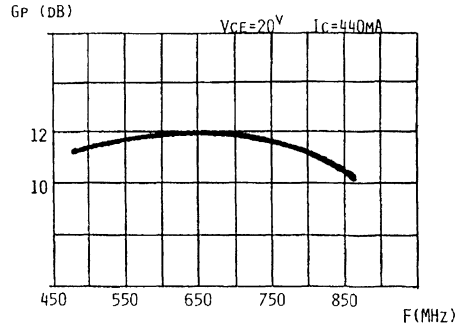
$f_3 = 864.5 MHz$  -7dBc

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs INPUT POWER**

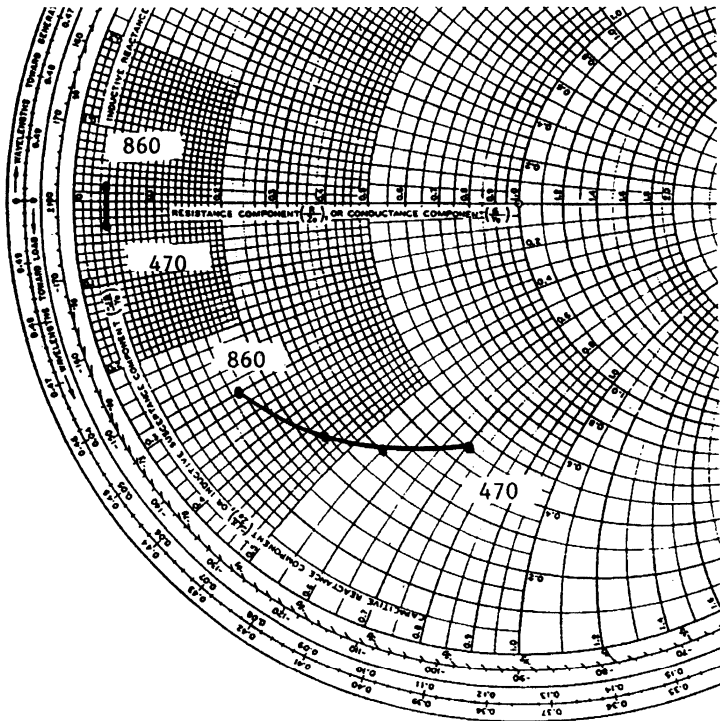


**BROADBAND POWER GAIN vs FREQUENCY**





## IMPEDANCE DATA



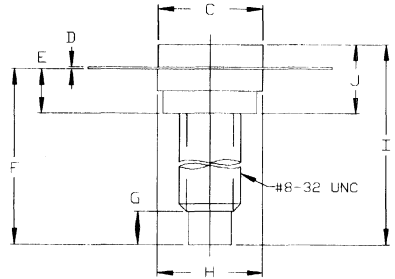
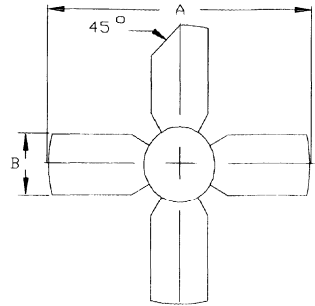
FREQ.	$Z_{IN} (\Omega)$	$Z_{OUT} (\Omega)$
860 MHz	$1.8 + j 0.8$	$8.0 - j 15.0$
650 MHz	$1.9 - j 0.5$	$15.0 - j 27.0$
470 MHz	$2.0 - j 1.5$	$23.0 - j 35.0$

$V_{CC} = 20 \text{ V}$   
 $I_C = 440 \text{ mA}$

PACKAGE MECHANICAL DATA

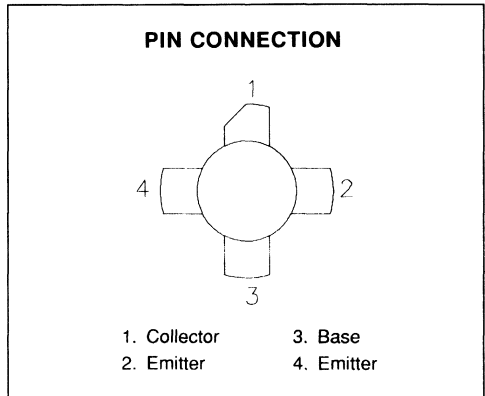
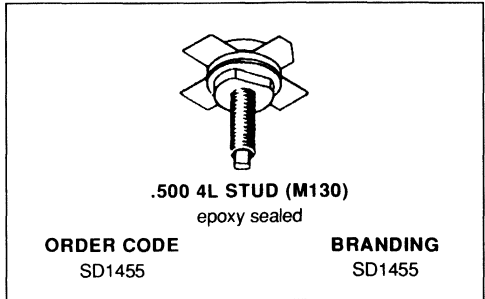
Ref.: Dwg. No.12-0122

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51



**RF & MICROWAVE TRANSISTORS  
TV/LINEAR APPLICATIONS**

- 170 - 230 MHz
- 25 VOLTS
- IMD - 55dB
- COMMON EMITTER
- GOLD METALLIZATION
- HIGH SATURATED POWER CAPABILITY
- DIFFUSED EMITTER BALLAST RESISTORS
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- P<sub>OUT</sub> = 20 W MIN. WITH 8.0 dB GAIN


**DESCRIPTION**

The SD1143 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class A operation in VHF and Band III television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CEO</sub>	Collector-Emitter Voltage	35	V
V <sub>CES</sub>	Collector-Emitter Voltage	60	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>c</sub>	Device Current	8.0	A
P <sub>DISS</sub>	Power Dissipation	140	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	1.5	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	65	—	—	V
$BV_{CER}$	$I_C = 50mA$	$R_{BE} = 10\Omega$	60	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	35	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CB} = 50V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	20	—	120	—

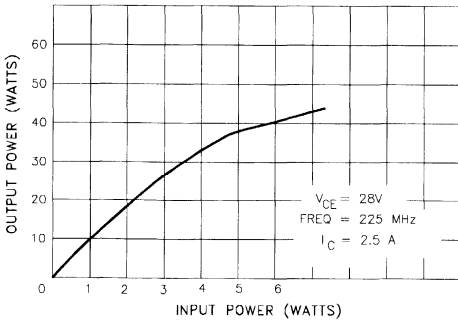
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 225\text{ MHz}$	$V_{CE} = 25\text{ V}$	$I_C = 2.5\text{ A}$	20	—	—	W
$G_P$	$f = 225\text{ MHz}$	$V_{CE} = 25\text{ V}$	$I_C = 2.5\text{ A}$	8.0	9.0	—	dB
$IMD_3^*$	$P_{OUT} = 14\text{ W}$	$V_{CE} = 25\text{ V}$	$I_C = 2.5\text{ A}$	—	-55	—	dBc
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 30\text{ V}$		—	—	85	pF

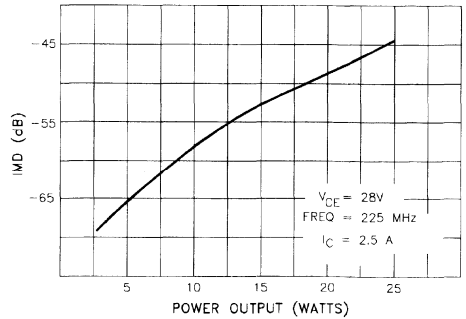
Note: \*  $f = 225\text{ MHz}$   
 3 Tone Testing  
 Vision Carrier  $-8dB/ref$   
 Sound Carrier  $-7dB/ref$   
 Sideband Carrier  $-16dB/ref$

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

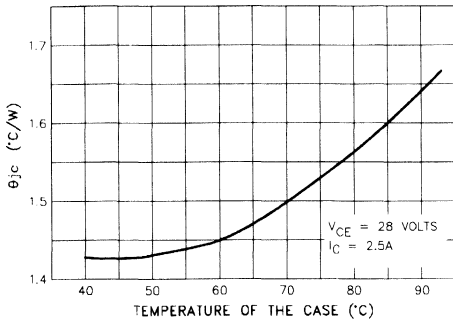


**INTERMODULATION DISTORTION vs POWER OUTPUT**

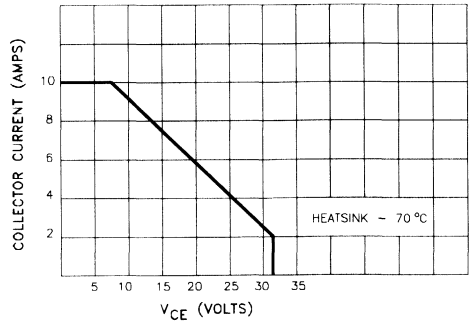


TYPICAL PERFORMANCE (CONT'D)

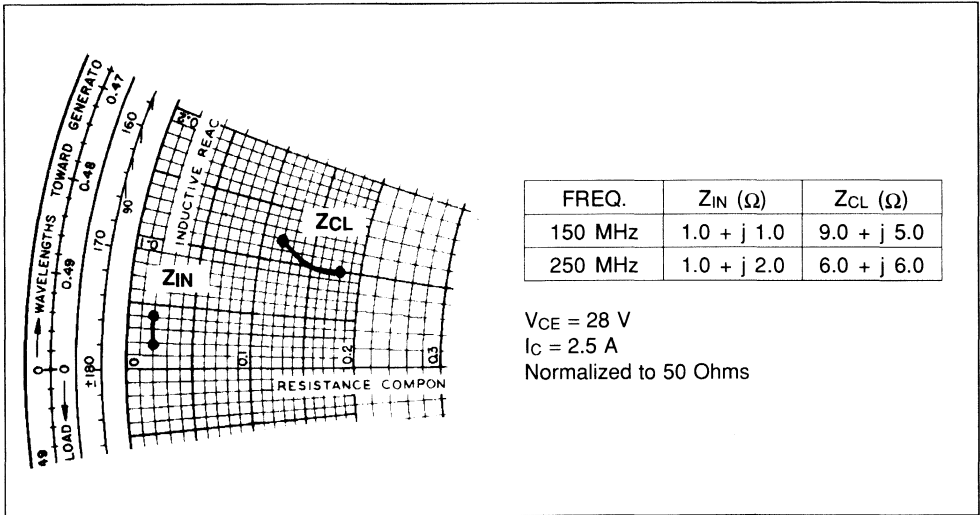
**THERMAL RESISTANCE vs CASE TEMPERATURE**



**SAFE OPERATING AREA**



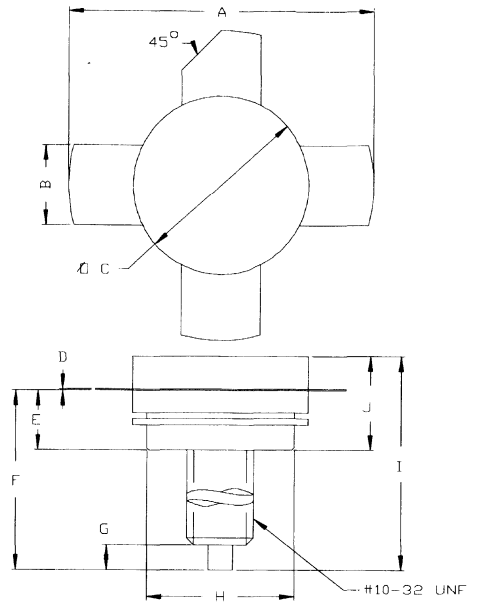
**IMPEDANCE DATA**



PACKAGE MECHANICAL DATA

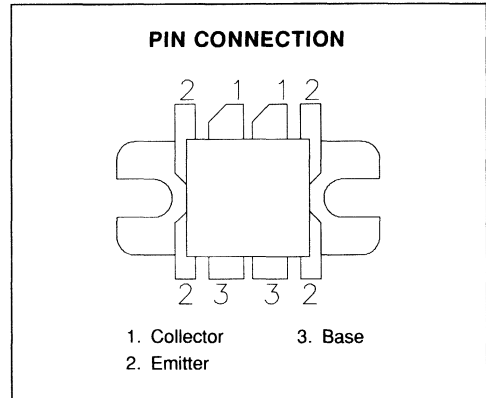
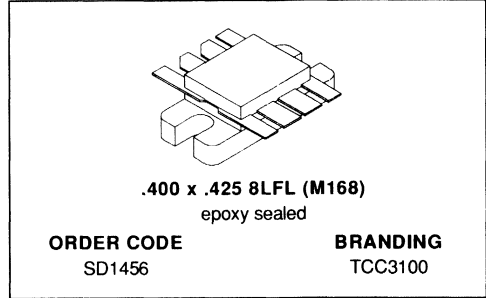
Ref.: Dwg. No.12-0130

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.050/26,67
B	.220/5,59	.230/5,84
C	.495/12,57	.505/12,83
D	.003/0,08	.007/0,18
E	.160/4,06	.180/4,57
F	.622/15,80	
G	.100/2,54	.130/3,31
H	.415/10,54	.425/10,80
I	.720/18,29	
J	.250/6,35	.290/7,37



**RF & MICROWAVE TRANSISTORS  
 TV/LINEAR APPLICATIONS**

- 170 - 230 MHz
- 28 VOLTS
- CLASS AB PUSH PULL
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- GOLD METALLIZATION
- DIFFUSED EMITTER BALLAST RESISTORS
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = 100 \text{ W MIN. WITH } 11.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1456 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in VHF and Band III television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	33	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	16	A
$P_{DISS}$	Power Dissipation	150	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.2	$^{\circ}\text{C}/\text{W}$
---------------	----------------------------------	-----	-----------------------------

# SD1456 (TCC3100)

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 50mA	R <sub>BE</sub> = 15Ω	60	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 50mA	I <sub>B</sub> = 0mA	33	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	I <sub>C</sub> = 0mA	3.5	—	—	V
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500mA	20	—	150	—

### DYNAMIC (Class AB)

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 225 MHz	V <sub>CE</sub> = 28 V	I <sub>C</sub> = 2 x 100 mA	100	—	—	W
G <sub>P</sub>	P <sub>OUT</sub> = 100 W	V <sub>CE</sub> = 28 V	I <sub>C</sub> = 2 x 100 mA	11	—	—	dB
η <sub>c</sub>	P <sub>OUT</sub> = 100 W	V <sub>CE</sub> = 28 V	I <sub>C</sub> = 2 x 100 mA	70	—	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	60	—	pF

### DYNAMIC (Class A)

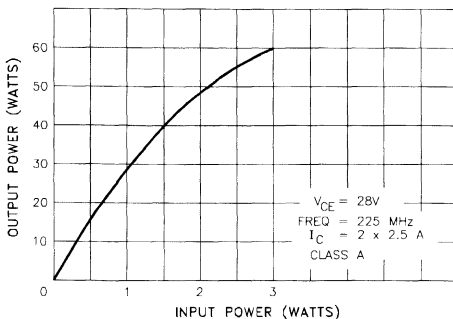
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub> *	f = 225 MHz	V <sub>CE</sub> = 28 V	I <sub>C</sub> = 2 x 2.5 A	28	32	—	W
G <sub>P</sub> *	P <sub>IN</sub> = 1.1 W	V <sub>CE</sub> = 28 V	I <sub>C</sub> = 2 x 2.5 A	14	15	—	dB
IMD <sub>3</sub> *	P <sub>IN</sub> = 1.1 W	V <sub>CE</sub> = 28 V	P <sub>REF</sub> = 28 W	—	-51	—	dB

Note: \* Class A Performance Characteristics Indicate Capability but are not Tested.

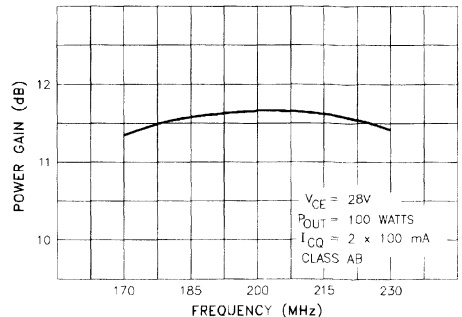
IMD3 - 3 Tone Measurement; -8, -7, -16dB relative to P<sub>REF</sub>

## TYPICAL PERFORMANCE

### POWER OUTPUT vs POWER INPUT

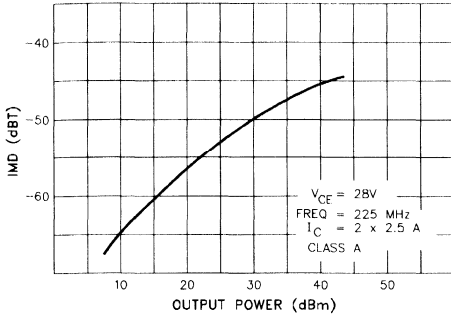
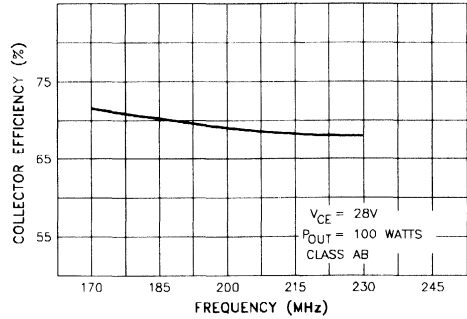


### BROADBAND POWER GAIN vs FREQUENCY

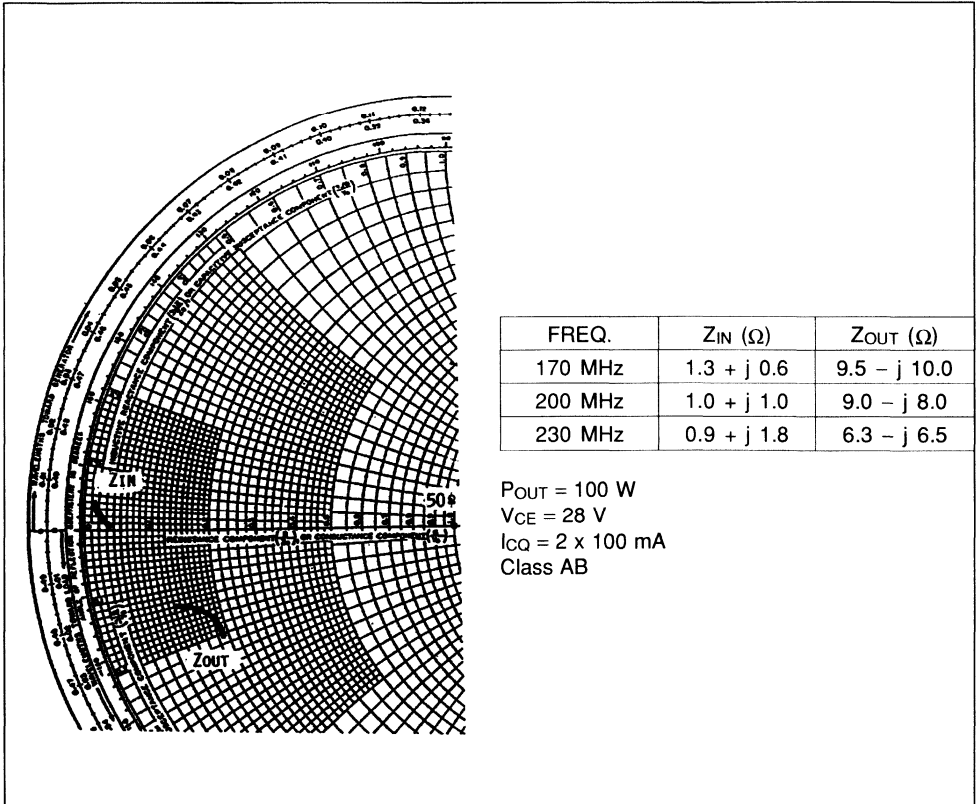




## TYPICAL PERFORMANCE (cont'd)

INTERMODULATION DISTORTION vs  
POWER OUTPUTCOLLECTOR EFFICIENCY vs  
FREQUENCY

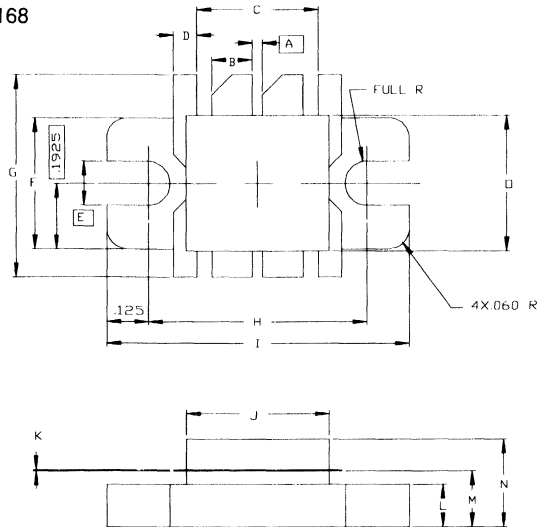
## IMPEDANCE DATA





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0168

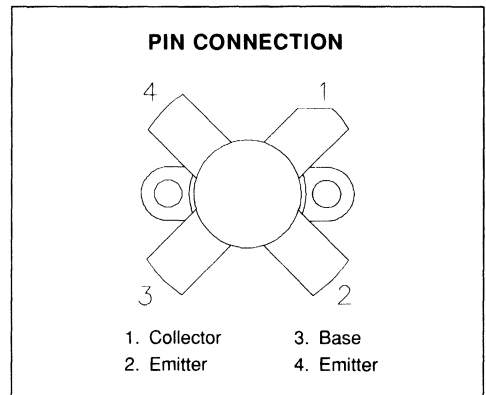
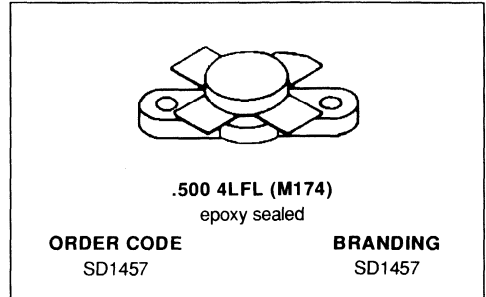


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A		.030/0,76	K	.003/0,08	.007/0,18
B	.115/2,92	.125/3,18	L	.120/3,05	.130/3,30
C		.360/9,14	M	.159/4,04	.175/4,45
D	.065/1,65	.075/1,91	N		.280/7,11
E		.130/3,30	Q	.395/10,03	.405/10,29
F	.380/9,65	.390/9,91			
G	.735/18,67	.765/19,43			
H	.645/16,38	.655/16,64			
I	.895/22,73	.905/22,99			
J	.420/10,67	.430/10,92			



**RF & MICROWAVE TRANSISTORS  
FM BROADCAST APPLICATIONS**

- 108 MHz
- 28 VOLTS
- EFFICIENCY 75%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 75 \text{ W MIN. WITH } 10.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1457 is a 28 V gold metallized epitaxial silicon NPN planar transistor designed for FM VHF broadcast transmitters.

This device utilizes diffused emitter resistors to achieve infinite VSWR at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{CES}$	Collector-Emitter Voltage	60	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	10	A
$P_{DISS}$	Power Dissipation	100	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

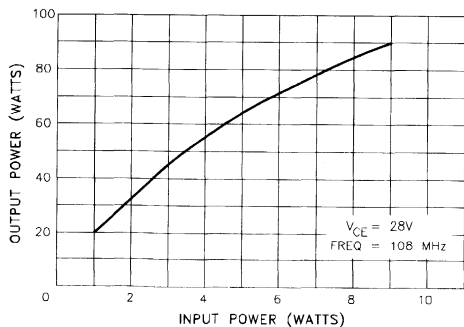
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{E}} = 0\text{mA}$	65	—	—	V
$BV_{\text{CER}}$	$I_{\text{C}} = 50\text{mA}$	$R_{\text{BE}} = 10\Omega$	60	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$	30	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 1\text{A}$	20	—	150	—

## DYNAMIC

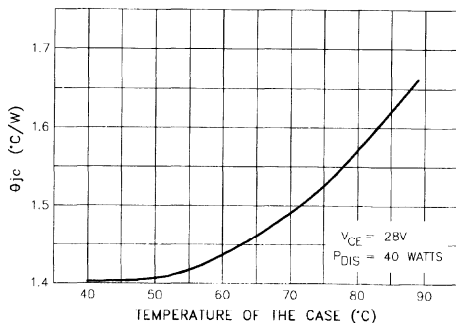
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 108\text{ MHz}$	$P_{\text{IN}} = 7.5\text{ W}$	$V_{\text{CE}} = 28\text{ V}$	75	—	—	W
$G_{\text{P}}$	$f = 108\text{ MHz}$	$P_{\text{IN}} = 7.5\text{ W}$	$V_{\text{CE}} = 28\text{ V}$	10	—	—	dB
$\eta_{\text{C}}$	$f = 108\text{ MHz}$	$P_{\text{IN}} = 7.5\text{ W}$	$V_{\text{CE}} = 28\text{ V}$	70	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 30\text{ V}$		—	—	85	pF

## TYPICAL PERFORMANCE

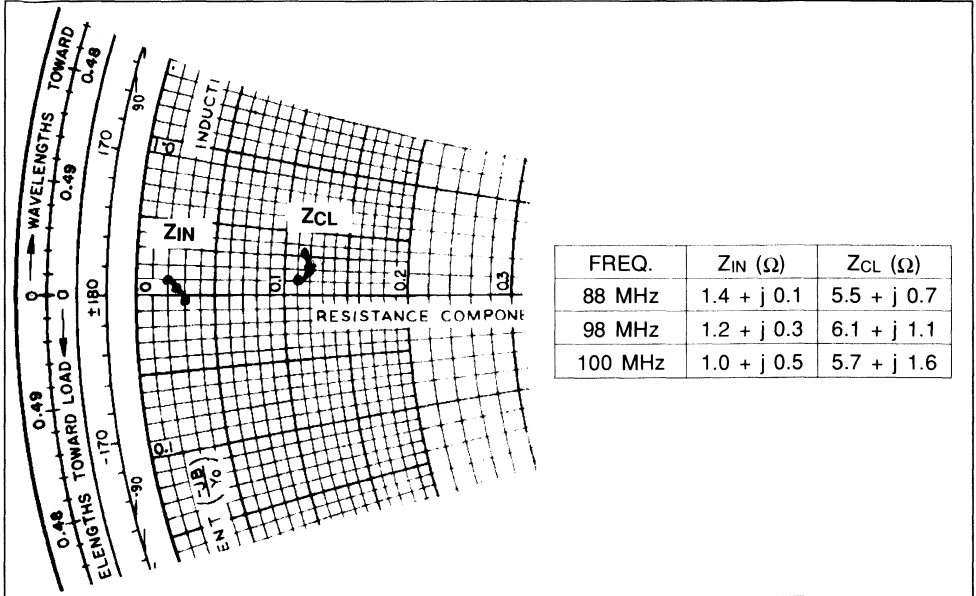
POWER OUTPUT vs POWER INPUT



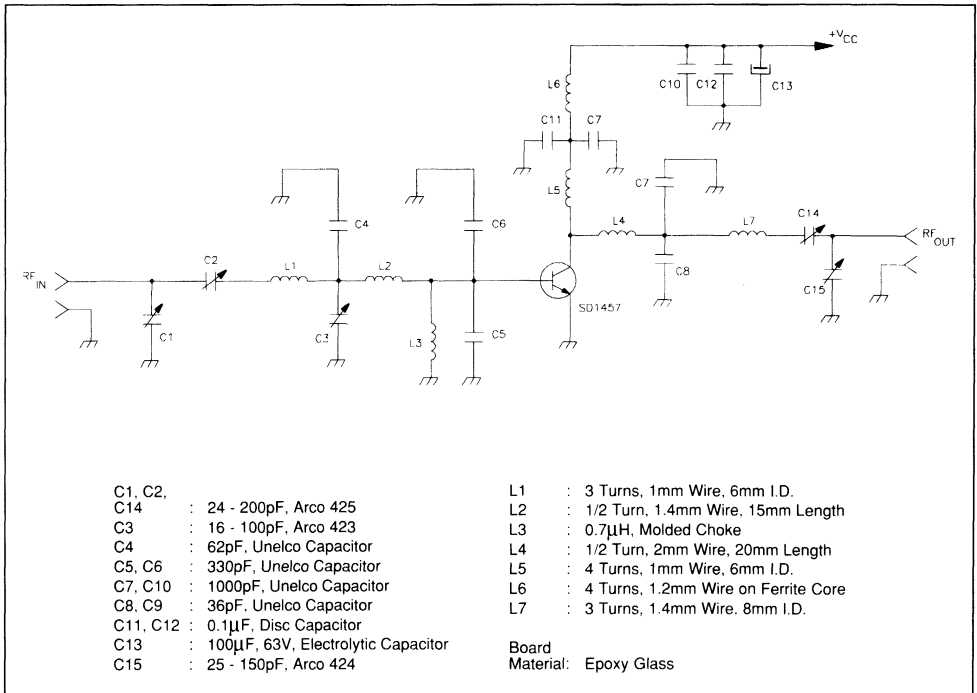
THERMAL RESISTANCE vs CASE TEMPERATURE



## IMPEDANCE DATA

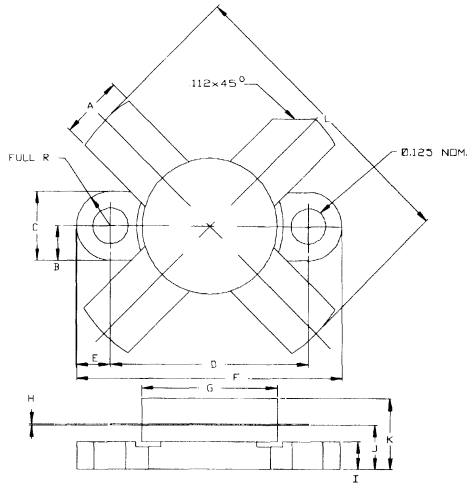


## TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0174

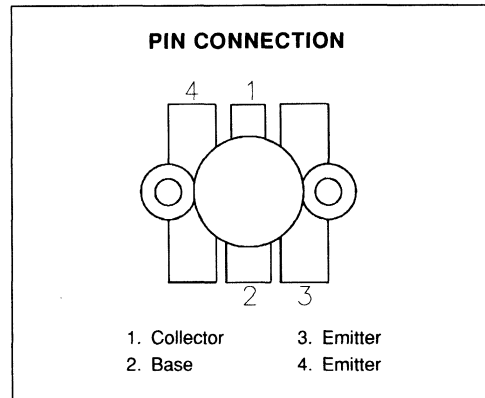
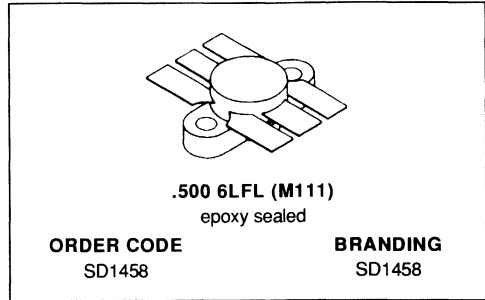


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K		.280/7,11
B	.125/3,18		L		1.050/26,67
C	.245/6,22	.255/6,48			
D	.720/18,28	.730/18,54			
E	.125/3,18				
F	.970/24,64	.980/24,89			
G	.495/12,57	.505/12,83			
H	.003/0,08	.007/0,18			
I	.090/2,29	.110/2,79			
J	.160/4,06	.175/4,45			



**RF & MICROWAVE TRANSISTORS  
 TV/LINEAR APPLICATIONS**

- 170 - 230 MHz
- 28 VOLTS
- IMD -55 dB
- COMMON EMITTER
- GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- HIGH SATURATED POWER CAPABILITY
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- $P_{OUT} = 14 \text{ W MIN. WITH } 14.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1458 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class A operation in VHF and band III television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	35	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	10	A
$P_{DISS}$	Power Dissipation	140	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CER}$	$I_C = 50mA$	$R_{BE} = 10\Omega$	60	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	35	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	10	—	100	—

## DYNAMIC

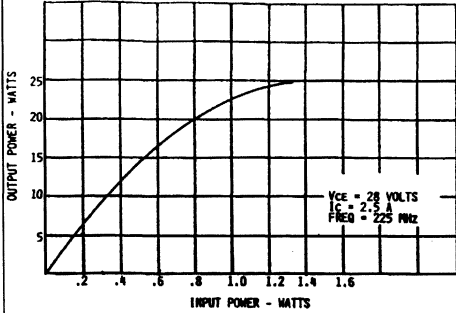
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 225 MHz$	$V_{CE} = 28 V$	$I_C = 2.5 A$	14	—	—	W
$G_P$	$f = 225 MHz$	$V_{CE} = 28 V$	$I_C = 2.5 A$	14	—	—	dB
$IMD_3$	$f = 225 MHz$	$V_{CE} = 28 V$	$I_C = 2.5 A$	—	—	-55	dBc
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	—	80	pF

Note:  $IMD_3$ 

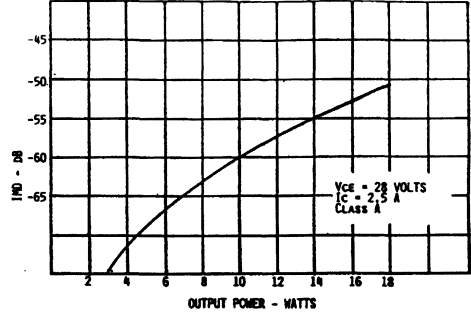
- Vision Carrier - 8dB
- Sound Carrier - 7dB
- Sideband Carrier - 16dB

## TYPICAL PERFORMANCE

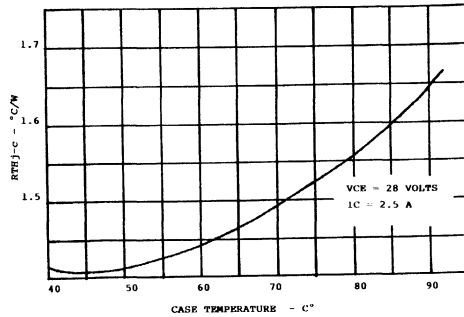
POWER OUTPUT vs POWER INPUT



IMD vs POWER OUTPUT

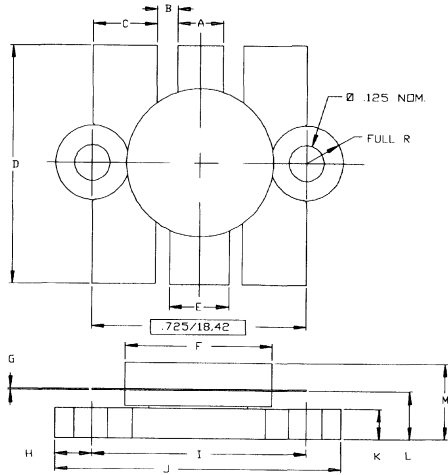


THERMAL RESISTANCE vs CASE TEMPERATURE



PACKAGE MECHANICAL DATA

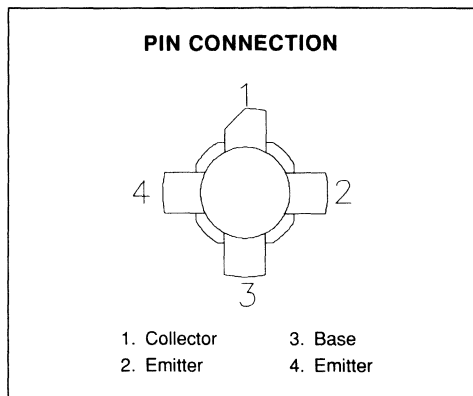
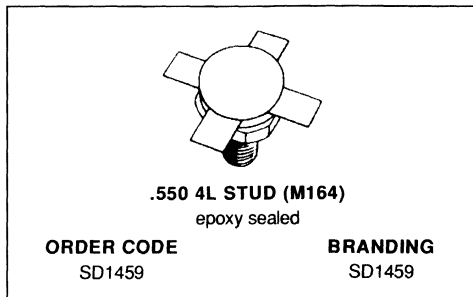
Ref.: Dwg. No.12-0111



SGS-THOMSON MICROELECTRONICS		CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41
B	.045/1,14		L	.150/3,81
C	.210/5,33	.220/5,59	M	.280/7,11
D	.835/21,21	.865/21,97		
E	.200/5,08	.210/5,33		
F	.490/12,45	.510/12,95		
G	.003/0,08	.007/0,18		
H	.125/3,18			
I	.720/18,29	.730/18,54		
J	.970/24,64	.980/24,89		

## RF & MICROWAVE TRANSISTORS TV/LINEAR APPLICATIONS

- 170 - 230 MHz
- 28 VOLTS
- IMD -53 dB
- COMMON EMITTER
- GOLD METALLIZATION
- HIGH SATURATED POWER CAPABILITY
- DIFFUSED EMITTER BALLAST RESISTORS
- P<sub>OUT</sub> = 20 W MIN. WITH 7.5 dB GAIN



### DESCRIPTION

The SD1459 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class A operation in VHF and Band III television transmitters and transposers.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	60	V
V <sub>CEO</sub>	Collector-Emitter Voltage	30	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>c</sub>	Device Current	16	A
P <sub>DISS</sub>	Power Dissipation	150	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	1.2	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

## STATIC

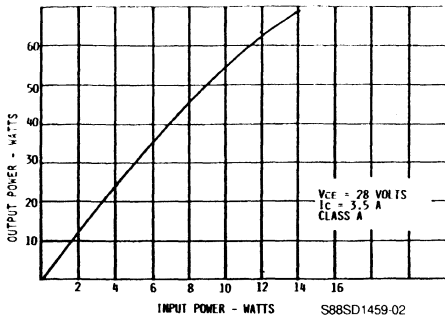
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 100mA$	$I_E = 0mA$	60	—	—	V
$BV_{CER}$	$I_C = 100mA$	$R_{BE} = 10\Omega$	60	—	—	V
$BV_{CEO}$	$I_C = 100mA$	$I_B = 0mA$	30	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$	4.0	—	—	V
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	10	—	120	—

## DYNAMIC

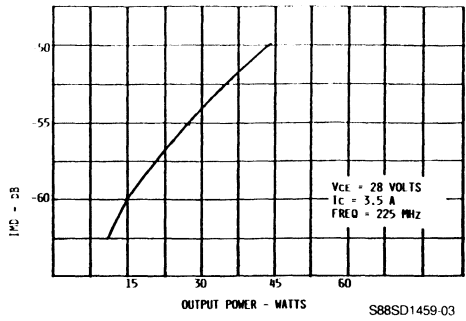
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 225\text{ MHz}$	$V_{CE} = 28\text{ V}$	$I_C = 3.5\text{ A}$	20	—	—	W
$G_P$	$f = 225\text{ MHz}$	$V_{CE} = 28\text{ V}$	$I_C = 3.5\text{ A}$	7.5	—	8.0	dB
IMD	$f = 225\text{ MHz}$	$V_{CE} = 28\text{ V}$	$I_C = 3.5\text{ A}$	—	-53	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 30\text{ V}$		—	—	150	pF

## TYPICAL PERFORMANCE

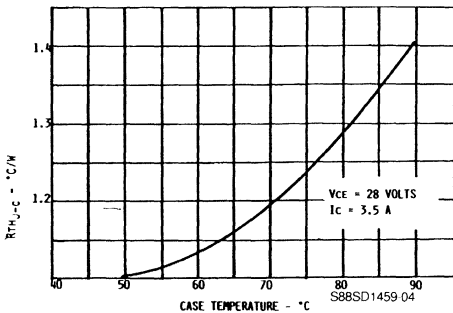
POWER OUTPUT vs POWER INPUT



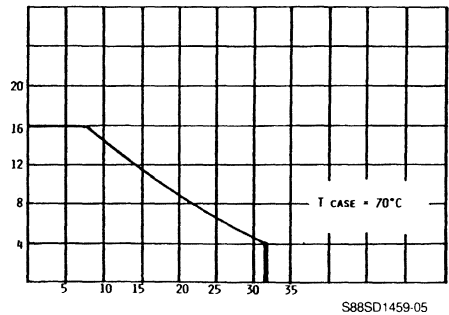
IMD vs POWER OUTPUT



THERMAL RESISTANCE vs CASE TEMPERATURE

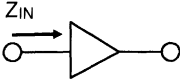


SAFE OPERATING AREA

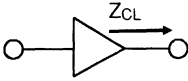


IMPEDANCE DATA

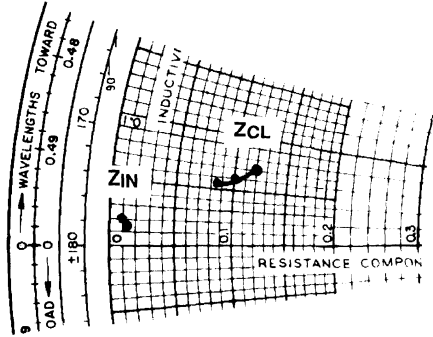
TYPICAL INPUT IMPEDANCE



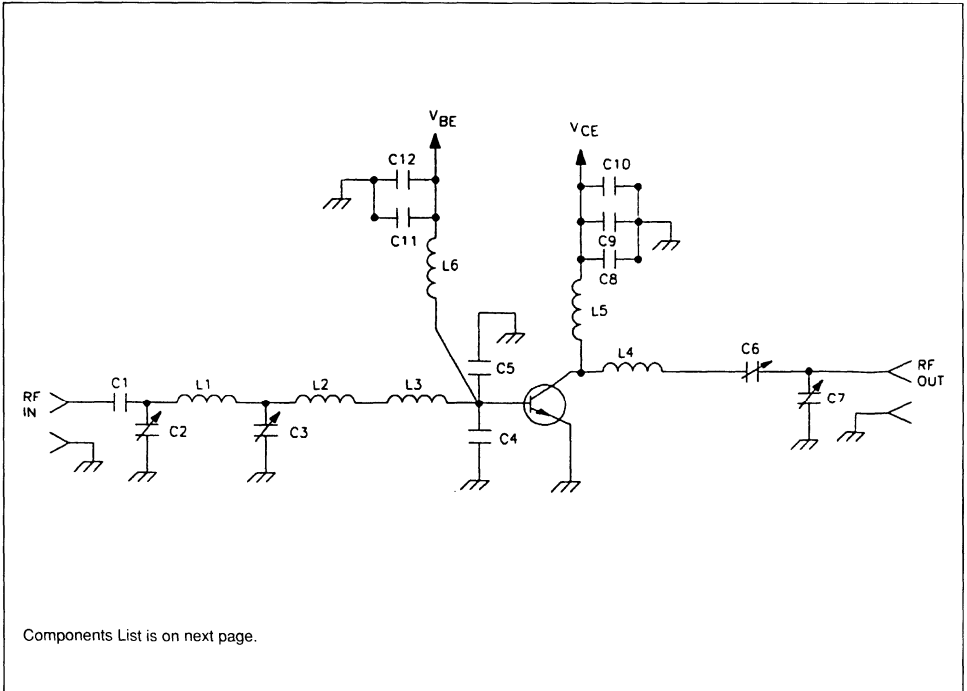
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
170 MHz	0.6 + j 0.7	5.9 + j 3.5
200 MHz	0.55 + j 0.8	5.0 + j 3.0
230 MHz	0.5 + j 0.9	4.2 + j 2.8



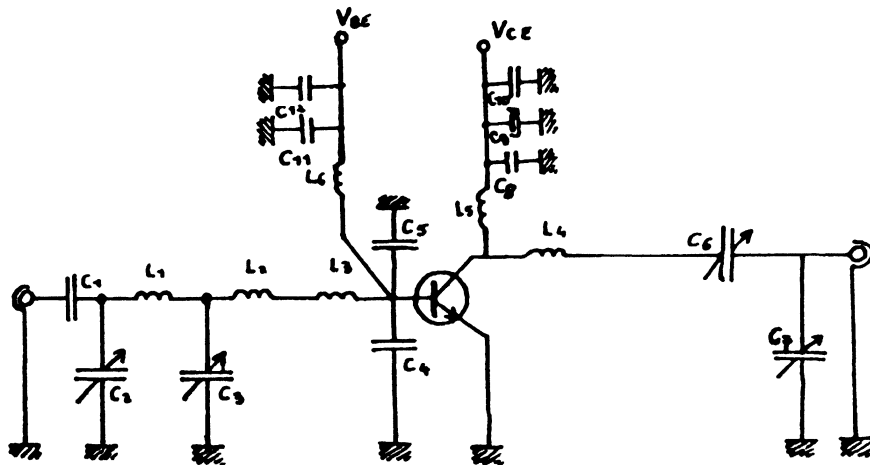
TEST CIRCUIT FOR 225 MHz



Components List is on next page.



## TEST CIRCUIT



S88SD1459.07

C1, C10 : 470 pF ATC 100 B Chip Capacitor  
 C2 : 4 - 40pF Arco 403 Trimmer Capacitor  
 C3 : 4 - 60pF Arco 404 Trimmer Capacitor  
 C4, C5 : 82pF ATC 100B Chip Capacitor  
 C6 : 24 - 200pF Arco 425 Trimmer Capacitor  
 C7 : 10 - 80pF Arco 405 Trimmer Capacitor  
 C8, C11 : 1 $\mu$ F LCC Chip Capacitor  
 C9 : 100 $\mu$ F 63V Electrolytic  
 C12 : 10mF LCC CPM13B

L1 : 1 1/2 Turns, 0.7mm Enameled Wire 4.5mm I.D.  
 L2 : 21mm 50 $\Omega$  Line  
 L3 : Length of the Base Lead  
 L4 : Enameled Wire 1.6mm Diameter

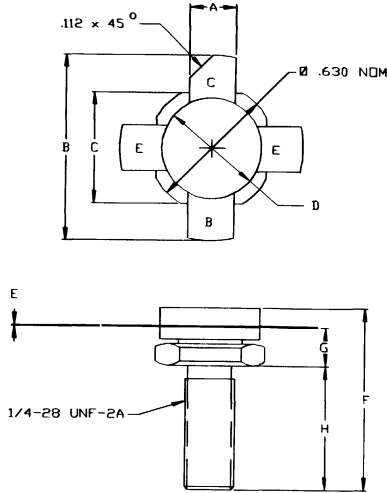
L5 : Enameled Wire 1.6mm Diameter

L6 : 9 Turns 0.7mm Enameled Wire 4.5mm 1.D.

Material: Epoxy 63 Mils Er = 2.55

PACKAGE MECHANICAL DATA

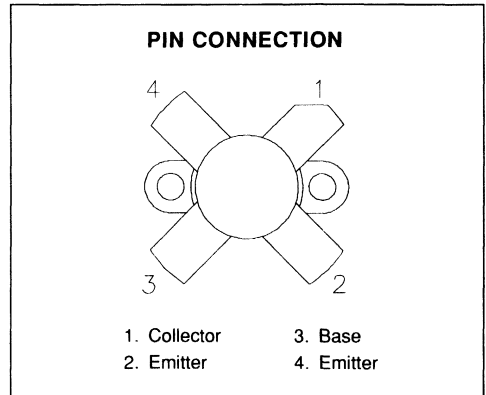
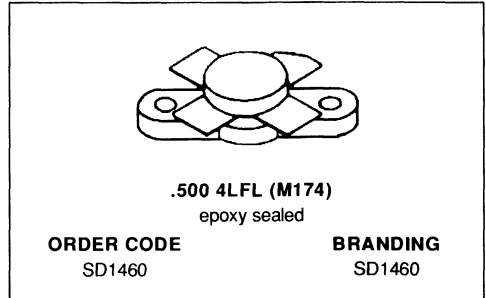
Ref.: Dwg. No.12-0164



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B		1.050/26,67
C	.545/13,84	.555/14,10
D	.495/12,57	.505/12,83
E	.003/0,08	.007/0,18
F		.830/21,08
G	.185/4,70	.198/5,03
H	.497/12,62	.530/13,46

## RF & MICROWAVE TRANSISTORS FM BROADCAST APPLICATIONS

- 108 MHz
- 28 VOLTS
- EFFICIENCY 75%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 150 \text{ W MIN. WITH } 9.2 \text{ dB GAIN}$



### DESCRIPTION

The SD1143 is a 28 V gold metallized epitaxial silicon NPN planar transistor designed for VHF FM broadcast transmitters. This device utilizes diffused emitter resistors to achieve infinite VSWR at rated operating conditions.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	25	V
$V_{CES}$	Collector-Emitter Voltage	60	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	16	A
$P_{DISS}$	Power Dissipation	230	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.75	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

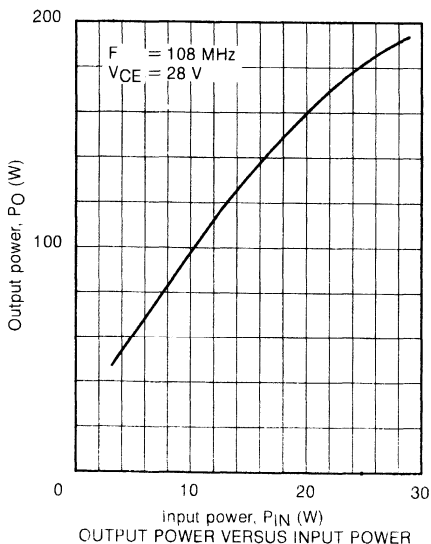
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 100mA$	$I_E = 0mA$	60	—	—	V
$BV_{CER}$	$I_C = 100mA$	$R_{BE} = 10\Omega$	55	—	—	V
$BV_{CEO}$	$I_C = 100mA$	$I_B = 0mA$	25	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$	4.0	—	—	V
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	20	—	150	—

DYNAMIC

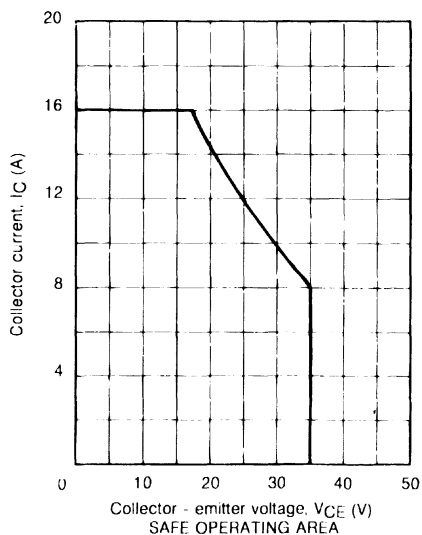
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 108\text{ MHz}$	$P_{IN} = 18\text{ W}$	$V_{CE} = 28\text{ V}$	150	—	—	W
$G_P$	$f = 108\text{ MHz}$	$P_{IN} = 18\text{ W}$	$V_{CE} = 28\text{ V}$	9.2	—	—	dB
$\eta_c$	$f = 108\text{ MHz}$	$P_{IN} = 18\text{ W}$	$V_{CE} = 28\text{ V}$	70	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	150	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

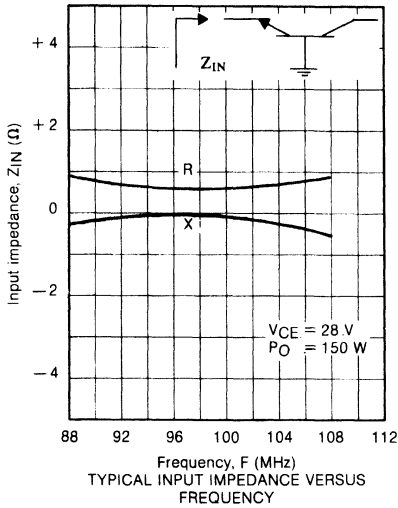


**SAFE OPERATING AREA**

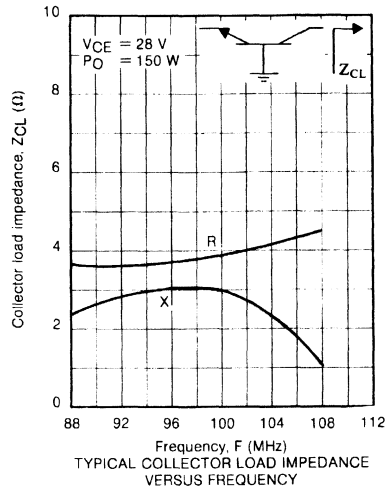


## IMPEDANCE DATA

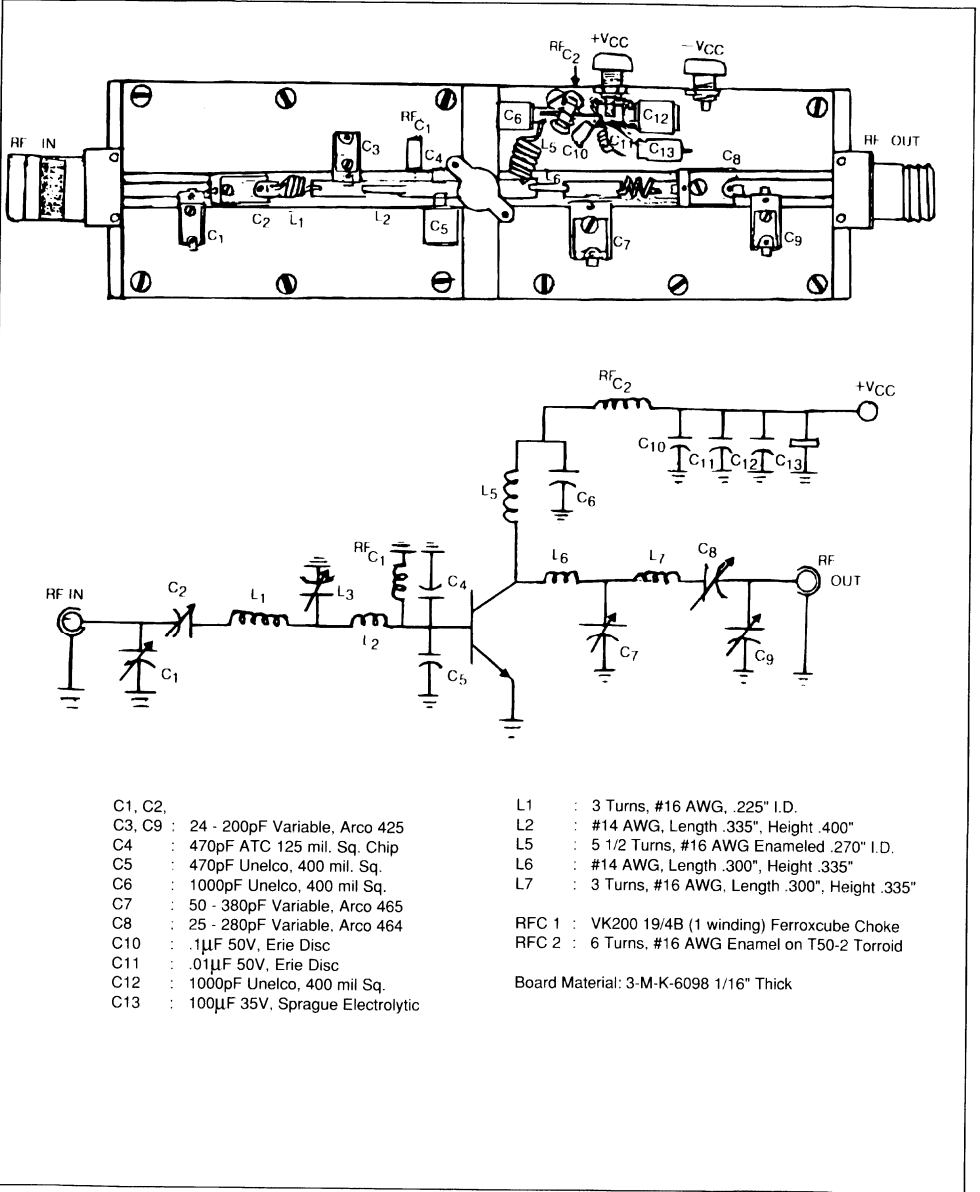
## TYPICAL INPUT IMPEDANCE



## TYPICAL COLLECTOR LOAD IMPEDANCE



TEST CIRCUIT



- C1, C2, : 24 - 200pF Variable, Arco 425
- C3, C9 : 470pF ATC 125 mil. Sq. Chip
- C4 : 470pF Unelco, 400 mil. Sq.
- C5 : 1000pF Unelco, 400 mil Sq.
- C6 : 50 - 380pF Variable, Arco 465
- C7 : 25 - 280pF Variable, Arco 464
- C8 : .1μF 50V, Erie Disc
- C10 : 1000pF Unelco, 400 mil Sq.
- C11 : .01μF 50V, Erie Disc
- C12 : 1000pF Unelco, 400 mil Sq.
- C13 : 100μF 35V, Sprague Electrolytic

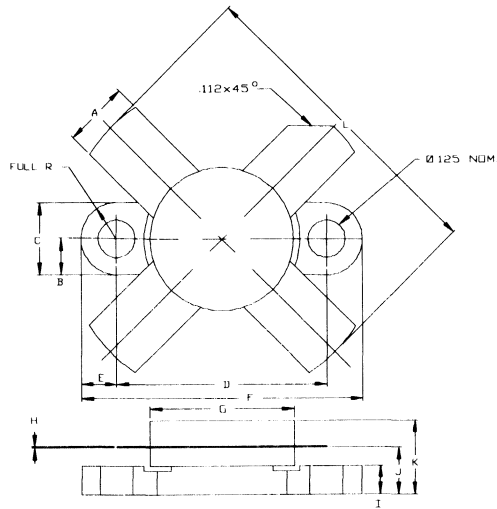
- L1 : 3 Turns, #16 AWG, .225" I.D.
- L2 : #14 AWG, Length .335", Height .400"
- L5 : 5 1/2 Turns, #16 AWG Enameled .270" I.D.
- L6 : #14 AWG, Length .300", Height .335"
- L7 : 3 Turns, #16 AWG, Length .300", Height .335"

- RF C 1 : VK200 19/4B (1 winding) Ferroxcube Choke
- RF C 2 : 6 Turns, #16 AWG Enamel on T50-2 Torroid

Board Material: 3-M-K-6098 1/16" Thick

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0174



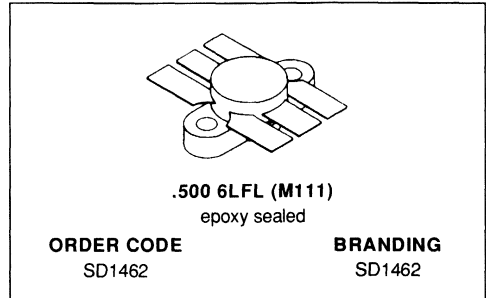
SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K		.280/7,11
B	.125/3,18		L		1.050/26,67
C	.245/6,22	.255/6,48			
D	.720/18,28	.730/18,54			
E	.125/3,18				
F	.970/24,64	.980/24,89			
G	.495/12,57	.505/12,83			
H	.003/0,08	.007/0,18			
I	.090/2,29	.110/2,79			
J	.160/4,06	.175/4,45			



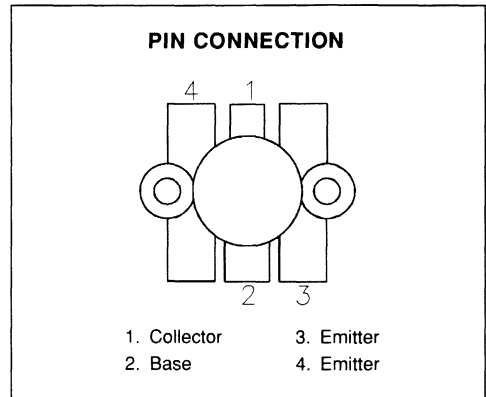


**RF & MICROWAVE TRANSISTORS  
 WIDEBAND VHF/UHF APPLICATIONS**

- 400 MHz
- 28 VOLTS
- EFFICIENCY 60%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 70 \text{ W MIN. WITH } 9.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1462 is a 28 V Class C epitaxial silicon NPN planar transistor designed primarily for UHF communications. This device utilizes diffused emitter resistors to achieve VSWR of 10:1 under operating conditions, and is internally input matched to optimize power gain and efficiency over the 225 - 400 MHz band.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	33	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	8.0	A
$P_{DISS}$	Power Dissipation	220	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.8	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

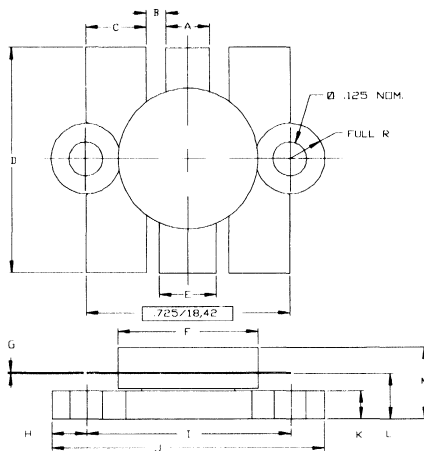
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$		60	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$		33	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$		4.0	—	—	V
$I_{CBO}$	$V_{CB} = 30V$	$I_E = 0mA$		—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$		20	—	120	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 400\text{ MHz}$	$P_{IN} = 8.8\text{ W}$	$V_{CE} = 28\text{ V}$	70	—	—	W
$G_P$	$f = 400\text{ MHz}$	$P_{IN} = 8.8\text{ W}$	$V_{CE} = 28\text{ V}$	9.0	—	—	dB
$\eta_c$	$f = 400\text{ MHz}$	$P_{IN} = 8.8\text{ W}$	$V_{CE} = 28\text{ V}$	—	60	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	65	—	pF

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0111

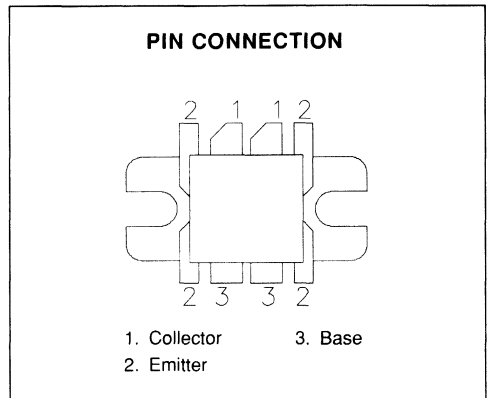
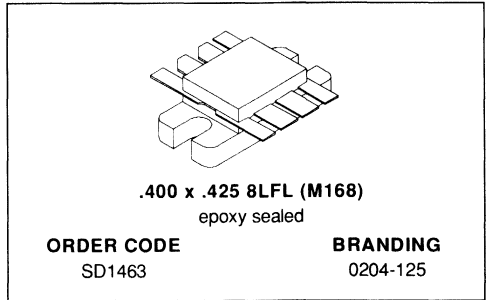


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			



**RF & MICROWAVE TRANSISTORS**  
**VHF/UHF APPLICATIONS**

- 400 MHz
- 28 VOLTS
- EFFICIENCY 60%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 125 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1463 is a 28 V Class C gold metallized epitaxial silicon NPN planar transistor designed for UHF military and commercial equipment. The SD1463 is an internally matched, broadband device optimized for operation within the 225 - 400 MHz frequency range. This device utilizes diffused emitter resistors to achieve 10:1 VSWR load mismatch capability at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	33	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	15	A
$P_{DISS}$	Power Dissipation	270	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.65	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{E}} = 0\text{mA}$	60	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 80\text{mA}$	$V_{\text{BE}} = 0\text{V}$	60	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$	33	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 20\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	10	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 1\text{A}$	20	—	200	—

## DYNAMIC

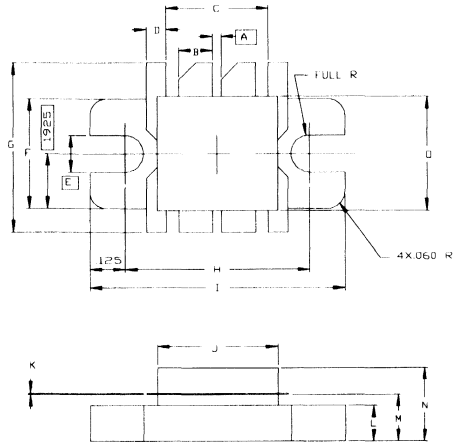
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 400\text{ MHz}$	$P_{\text{IN}} = 25\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	125	—	—	W
$G_{\text{P}}$	$f = 400\text{ MHz}$	$P_{\text{IN}} = 25\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	7.0	—	—	dB
$\eta_{\text{c}}$	$f = 400\text{ MHz}$	$P_{\text{IN}} = 25\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	60	—	—	%

## IMPEDANCE DATA

FREQ.	$Z_{\text{IN}} (\Omega)$	$Z_{\text{CL}} (\Omega)$
225 MHz	$0.5 + j 2.5$	$8.8 + j 3.5$
400 MHz	$1.5 + j 1.7$	$5.0 + j 0.0$

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0168



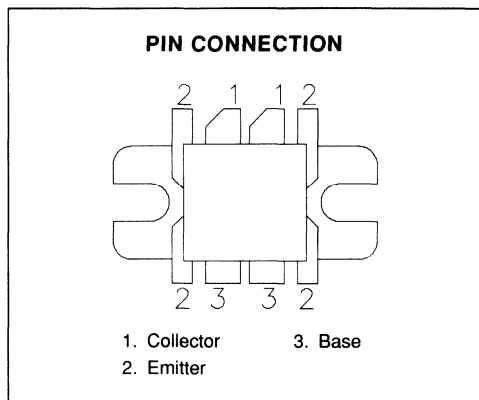
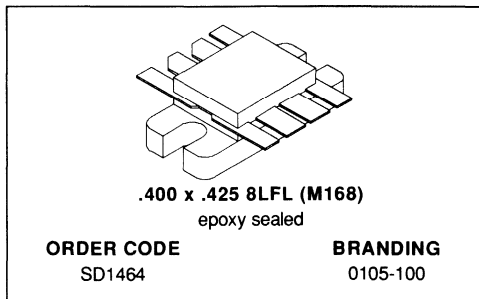
SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A		.030/0,76	K	.003/0,08	.007/0,18
B	.115/2,92	.125/3,18	L	.120/3,05	.130/3,30
C		.360/9,14	M	.159/4,04	.175/4,45
D	.065/1,65	.075/1,91	N		.280/7,11
E		.130/3,30	Q	.395/10,03	.405/10,29
F	.380/9,65	.390/9,91			
G	.735/18,67	.765/19,43			
H	.645/16,38	.655/16,64			
I	.895/22,73	.905/22,99			
J	.420/10,67	.430/10,92			





**RF & MICROWAVE TRANSISTORS**  
**VHF/UHF APPLICATIONS**

- 500 MHz
- 28 VOLTS
- EFFICIENCY 55%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 100 \text{ W MIN. WITH } 5.5 \text{ dB GAIN}$


**DESCRIPTION**

The SD1464 is a 28 V gold metallized, Class C epitaxial silicon NPN planar transistor designed for UHF military and commercial equipment. The SD1464 is an internally matched, broadband device optimized for operation within the 100 - 500 MHz frequency range. This device utilizes diffused emitter resistors to achieve 5:1 VSWR load mismatch capability at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	33	V
$V_{CES}$	Collector-Emitter Voltage	60	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	15	A
$P_{DISS}$	Power Dissipation	260	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.67	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**SD1464 (TCC0105-100)****ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )**STATIC**

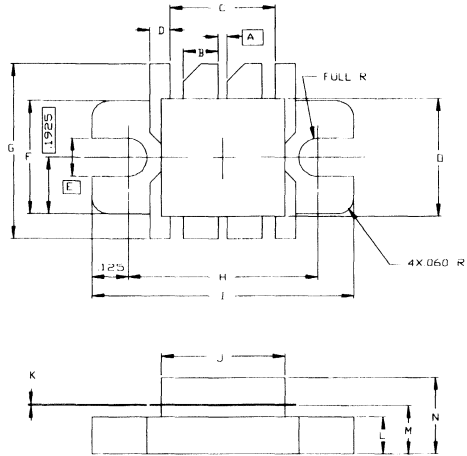
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 100mA$	$I_E = 0mA$		60	—	—	V
$BV_{CES}$	$I_C = 80mA$	$V_{BE} = 0V$		60	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$		33	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$		4.0	—	—	V
$I_{CBO}$	$V_{CB} = 30V$	$I_E = 0mA$		—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$		20	—	—	—

**DYNAMIC**

Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{OUT}$	$f = 500\text{ MHz}$	$P_{IN} = 28.2\text{ W}$	$V_{CE} = 28\text{ V}$		100	—	—	W
$G_P$	$f = 500\text{ MHz}$	$P_{IN} = 28.2\text{ W}$	$V_{CE} = 28\text{ V}$		5.5	—	—	dB
$\eta_c$	$f = 500\text{ MHz}$	$P_{IN} = 28.2\text{ W}$	$V_{CE} = 28\text{ V}$		55	—	—	%

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0168

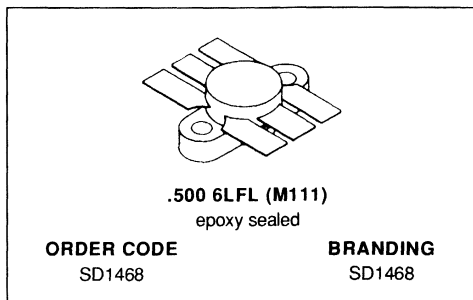
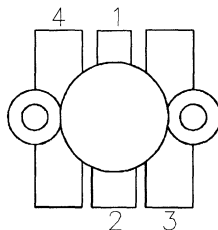


SGS-THOMSON MICROELECTRONICS		CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A		.030/0,76	K	.003/0,08
B	.115/2,92	.125/3,18	L	.120/3,05
C		.360/9,14	M	.159/4,04
D	.065/1,65	.075/1,91	N	
E		.130/3,30	□	.395/10,03
F	.380/9,65	.390/9,91		.405/10,29
G	.735/18,67	.765/19,43		
H	.645/16,38	.655/16,64		
I	.895/22,73	.905/22,99		
J	.420/10,67	.430/10,92		



**RF & MICROWAVE TRANSISTORS  
VHF/UHF APPLICATIONS**

- 400 MHz
- 28 VOLTS
- INPUT MATCHED
- COMMON EMITTER
- GOLD METALLIZATION
- P<sub>OUT</sub> = 70 W MIN. WITH 8.4 dB GAIN


**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

**DESCRIPTION**

The SD1468 is a 28 V Class C gold metallized, epitaxial silicon NPN planar transistor designed for UHF military and commercial equipment. The SD1468 is an internally matched, broadband device optimized for operation within the 200 - 500 MHz frequency range. This device utilizes diffused emitter resistors to achieve a VSWR of 20:1 at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	60	V
V <sub>CEO</sub>	Collector-Emitter Voltage	30	V
V <sub>CES</sub>	Collector-Emitter Voltage	60	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>c</sub>	Device Current	8.0	A
P <sub>DISS</sub>	Power Dissipation	140	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	1.25	°C/W
----------------------	----------------------------------	------	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

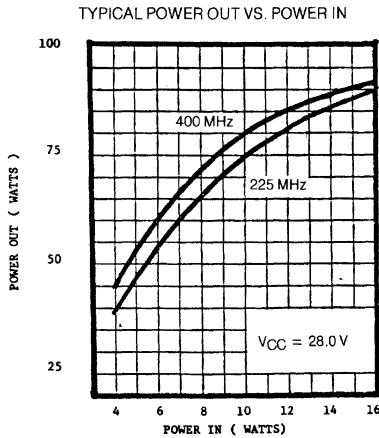
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	60	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	30	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CEO}$	$V_{CE} = 30V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	10	—	80	—

DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 400\text{ MHz}$	$P_{IN} = 10\text{ W}$	$V_{CC} = 28\text{ V}$	70	—	—	W
$G_P$	$f = 400\text{ MHz}$	$P_{IN} = 10\text{ W}$	$V_{CC} = 28\text{ V}$	8.4	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	80	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

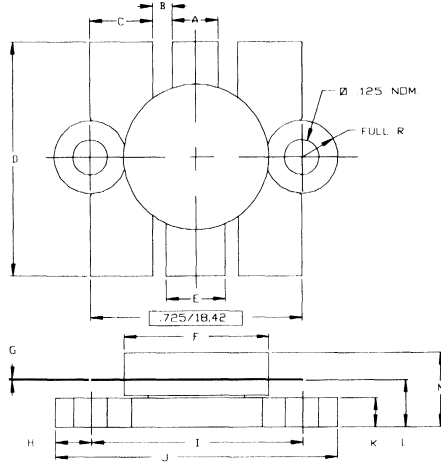


**IMPEDANCE DATA**

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
225 MHz	$1.44 - j 0.87$	$1.70 - j 2.6$
400 MHz	$1.29 + j 0.87$	$3.0 + j 0.87$

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0111



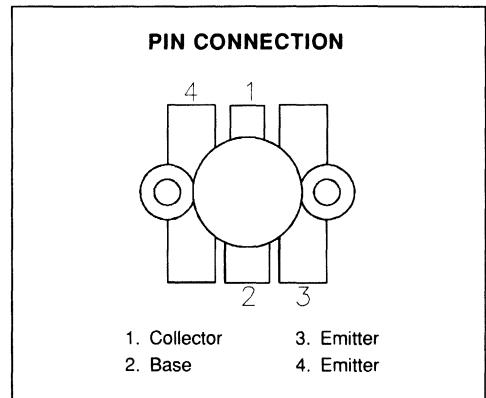
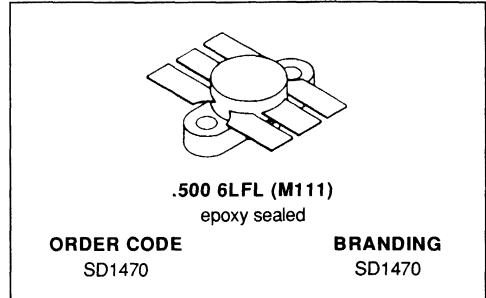
SGS-THOMSON MICROELECTRONICS			COND'T'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41 .105/2,67
B	.045/1,14		L	.150/3,81 .170/4,32
C	.210/5,33	.220/5,59	M	.280/7,11
D	.835/21,21	.865/21,97		
E	.200/5,08	.210/5,33		
F	.490/12,45	.510/12,95		
G	.003/0,08	.007/0,18		
H	.125/3,18			
I	.720/18,29	.730/18,54		
J	.970/24,64	.980/24,89		





**RF & MICROWAVE TRANSISTORS  
 WIDEBAND VHF/UHF APPLICATIONS**

- 400 MHz
- 28 VOLTS
- EFFICIENCY 60%
- INPUT MATCHED
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 100$  W MIN. WITH 7.0 dB GAIN


**DESCRIPTION**

The SD1470 is a 28 V Class C epitaxial silicon NPN planar transistor designed primarily for UHF communications. The device utilizes diffused emitter resistors to achieve infinite VSWR under operating conditions, and is internally input matched to optimize power gain and efficiency over the band.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	33	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	4.0	A
$P_{DISS}$	Power Dissipation	250	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.7	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

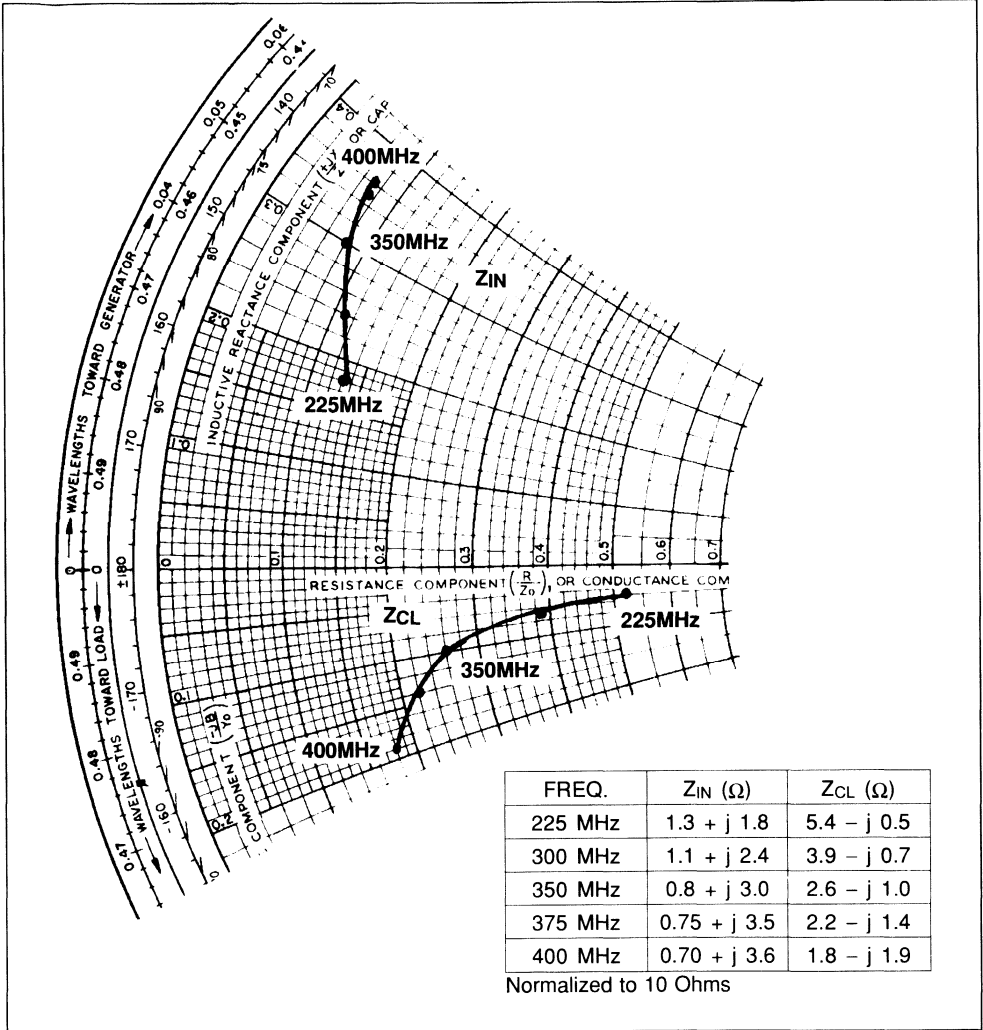
## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 100mA$	$I_E = 0mA$	60	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	33	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 28V$	$I_E = 0mA$	—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	20	—	200	—

## DYNAMIC

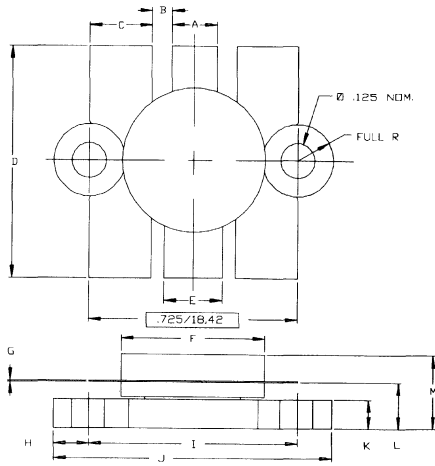
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 400\text{ MHz}$	$P_{IN} = 20\text{ W}$	$V_{CE} = 28\text{ V}$	100	—	—	W
$G_P$	$f = 400\text{ MHz}$	$P_{IN} = 20\text{ W}$	$V_{CE} = 28\text{ V}$	7.0	—	—	dB
$\eta_c$	$f = 400\text{ MHz}$	$P_{IN} = 20\text{ W}$	$V_{CE} = 28\text{ V}$	—	60	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	100	—	pF

## IMPEDANCE DATA



PACKAGE MECHANICAL DATA

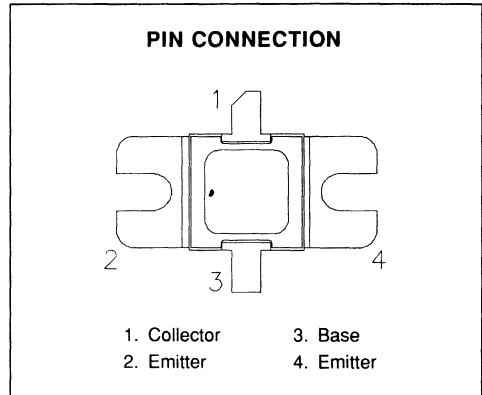
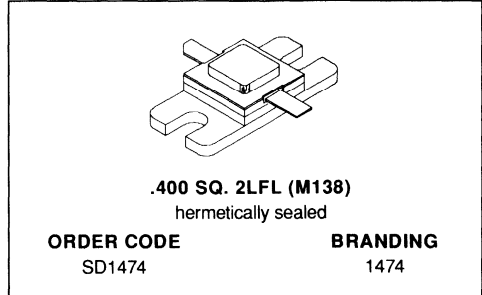
Ref.: Dwg. No.12-0111



SGS - THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			

**RF & MICROWAVE TRANSISTORS  
 UHF PULSED APPLICATIONS**

- 425 MHz
- 28 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- EMITTER BALLASTED
- $P_{OUT} = 48 \text{ W MIN. WITH } 6.8 \text{ dB GAIN}$


**DESCRIPTION**

The SD1474 is a Class C, 28 V common emitter device optimized for pulsed applications in the 400 - 500 MHz frequency range. Refractory gold metallization and emitter ballasting ensure long-term reliability as well as device ruggedness under severe load mismatch conditions.

SD1474 is characterized for both CW and pulsed operation and is provided in an industry -standard .400" Sq. hermetic package.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CES}$	Collector-Emitter Voltage	60	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	5	A
$P_{DISS}$	Power Dissipation	87.5	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

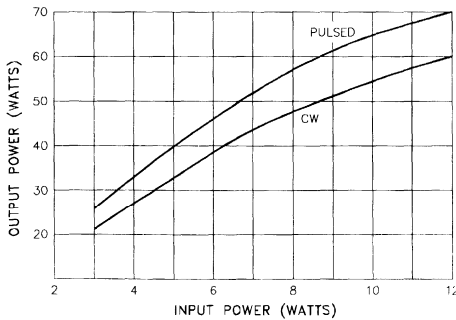
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	60	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	60	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	32	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 30V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	20	—	100	—

**DYNAMIC**

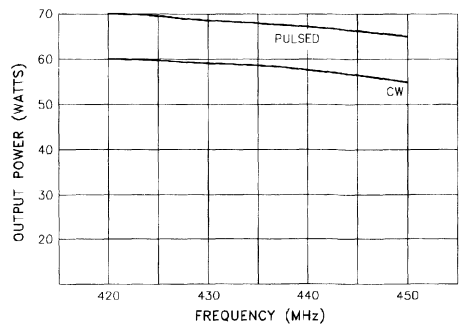
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 425\text{ MHz}$	$P_{IN} = 10\text{ W}$	$V_{CE} = 28\text{ V}$	48	—	—	W
$G_P$	$f = 425\text{ MHz}$	$P_{IN} = 10\text{ W}$	$V_{CE} = 28\text{ V}$	6.8	—	—	dB
$\eta_C$	$f = 425\text{ MHz}$	$P_{IN} = 10\text{ W}$	$V_{CE} = 28\text{ V}$	50	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	42	—	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

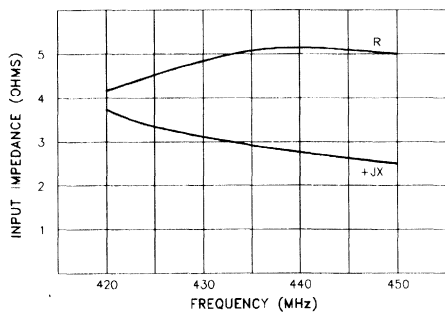


**POWER OUTPUT vs FREQUENCY**

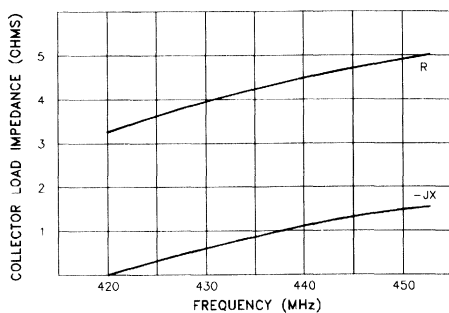


## IMPEDANCE DATA

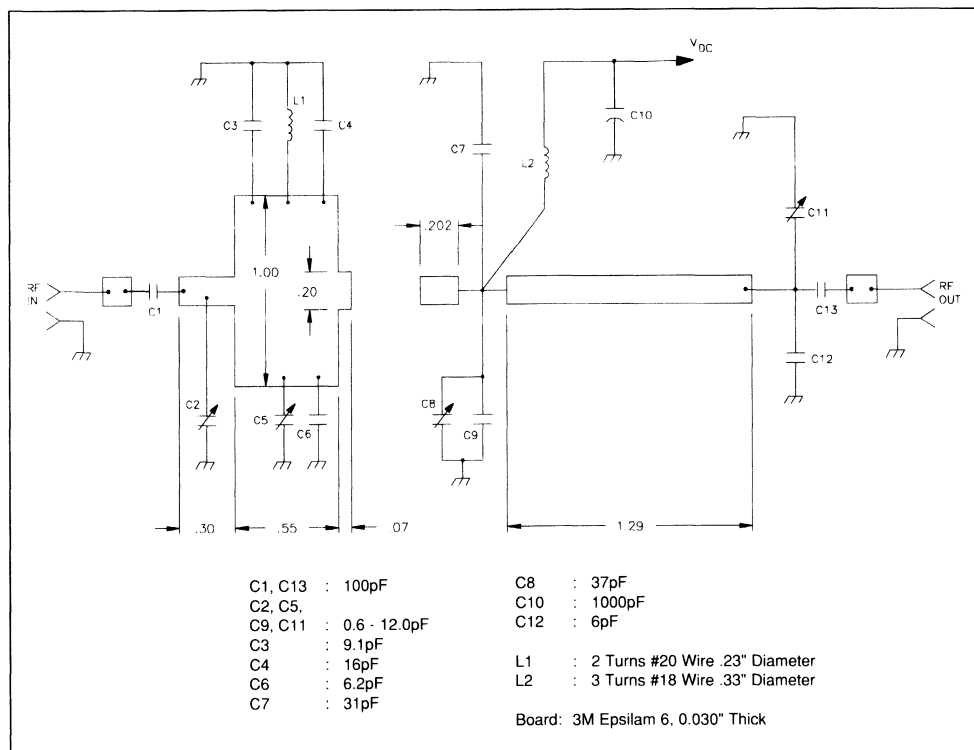
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

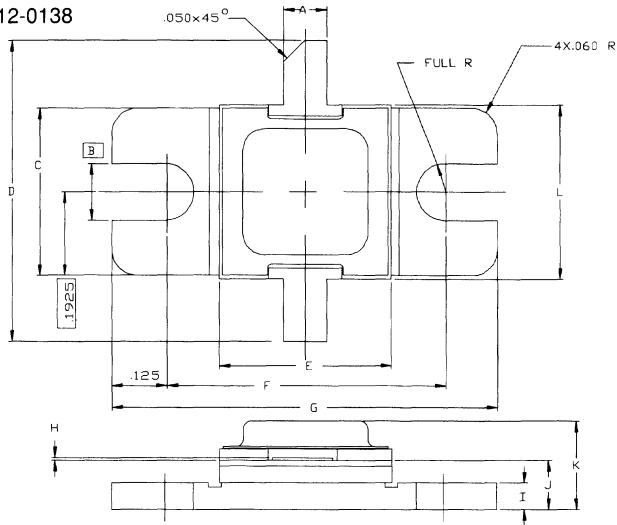


## TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0138

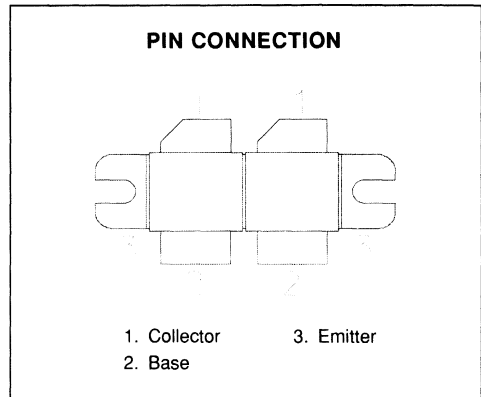
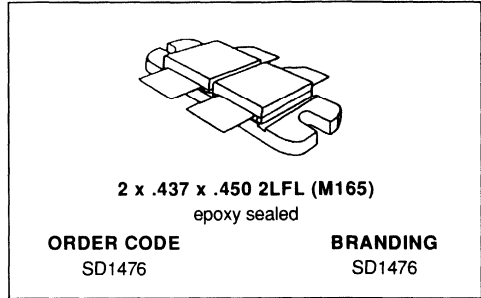


SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	.105/2,67	K	.230/5,84
B	.125/3,18		L	.392/9,96
C	.380/9,65	.390/9,91		
D	.780/19,81			
E	.392/9,96	.408/10,36		
F	.645/16,38	.655/16,64		
G	.895/22,73	.905/22,99		
H	.002/0,05	.006/0,15		
I	.055/1,40	.065/1,65		
J	.105/2,67	.130/3,30		



**RF & MICROWAVE TRANSISTORS  
 TV/LINEAR APPLICATIONS**

- 55 - 88 MHz
- 32 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- CLASS AB PUSH PULL
- HIGH SATURATED POWER CAPABILITY
- DIFFUSED EMITTER BALLAST RESISTORS
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- $P_{OUT} = 240 \text{ W MIN. WITH } 12.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1476 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in VHF and Band I television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	70	V
$V_{CEO}$	Collector-Emitter Voltage	40	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	25	A
$P_{DISS}$	Power Dissipation	430	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 50 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.4	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	70	—	—	V
$BV_{CER}$	$I_C = 50mA$	$R_{BE} = 51\Omega$	68	—	—	V
$BV_{CEO}$	$I_C = 100mA$	$I_B = 0mA$	40	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CEO}$	$V_{CE} = 30V$	$I_E = 0mA$	—	—	10	mA
$I_{CBO}$	$V_{CB} = 30V$	$I_E = 0mA$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 7A$	10	—	50	—

## DYNAMIC

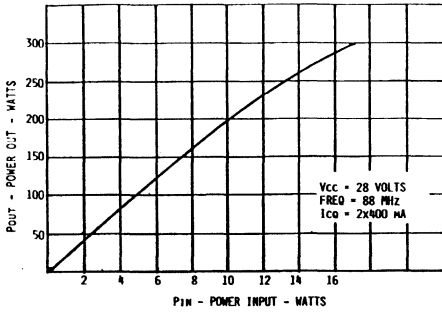
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}^*$	$f = 88\text{ MHz}$	$V_{CE} = 32\text{ V}$	$I_{CQ} = 2 \times 400mA$	240	—	—	W
$G_P$	$f = 88\text{ MHz}$	$V_{CE} = 32\text{ V}$	$I_{CQ} = 2 \times 400mA$	12	—	—	dB
$\eta_C$	$f = 88\text{ MHz}$	$V_{CE} = 32\text{ V}$	$I_{CQ} = 2 \times 400mA$	50	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	—	220	pF

Note: \*1 dB Compression

## TYPICAL PERFORMANCE

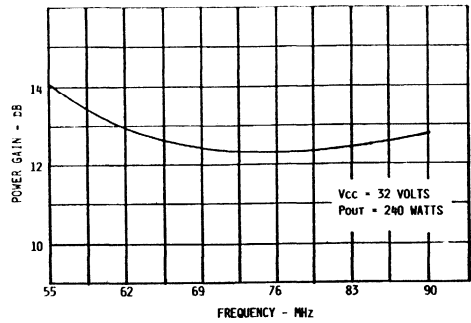
## POWER OUTPUT vs POWER INPUT

POWER OUTPUT VS POWER INPUT

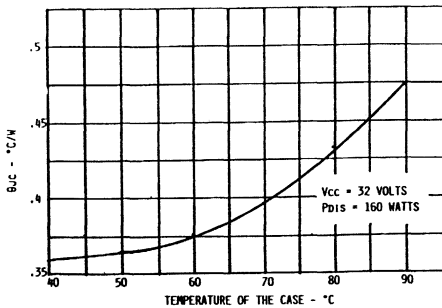


## POWER GAIN vs FREQUENCY

BROADBAND POWER GAIN VS FREQUENCY

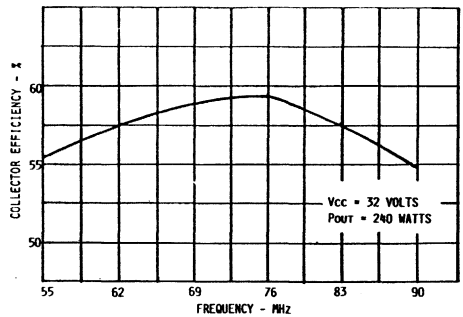


## THERMAL RESISTANCE vs CASE TEMPERATURE

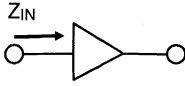
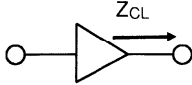
IR SCAN HOT SPOT  $\theta_{JC}$  VS CASE TEMPERATURE

## COLLECTOR EFFICIENCY vs FREQUENCY

EFFICIENCY VS FREQUENCY

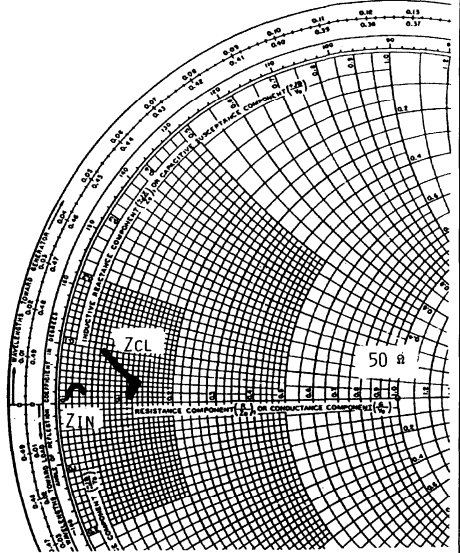


## IMPEDANCE DATA

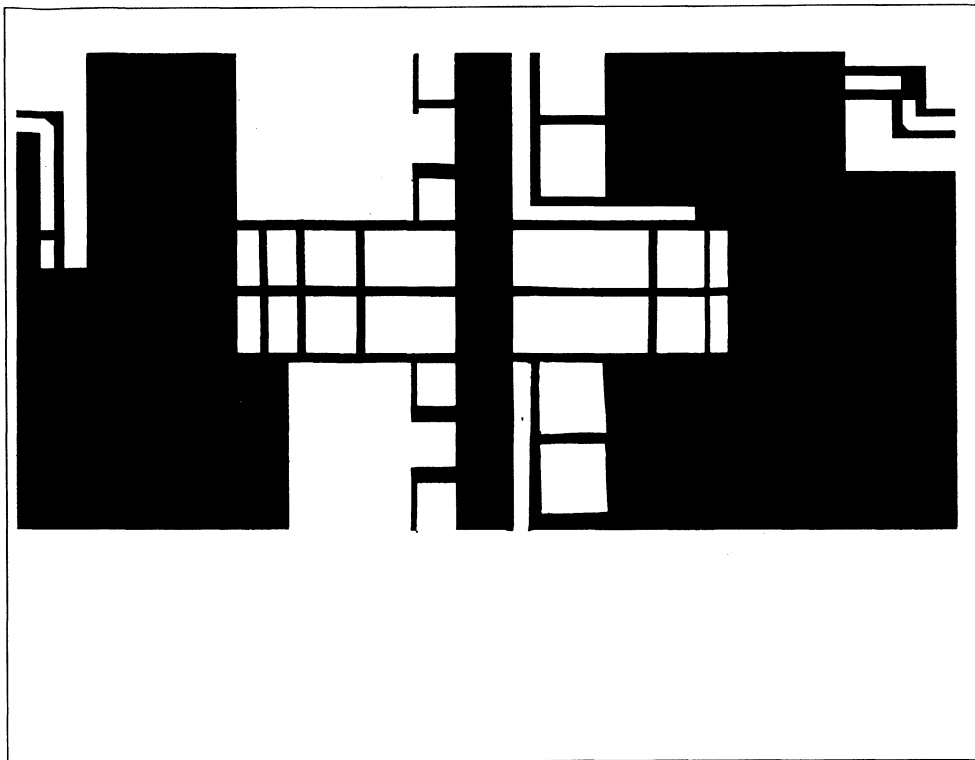
TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
55 MHz	$1.7 + j 1.0$	$6.1 + j 1.0$
65 MHz	$1.5 + j 1.3$	$7.0 + j 2.1$
75 MHz	$1.0 + j 1.1$	$6.2 + j 2.0$
90 MHz	$0.8 + j 0.4$	$3.4 + j 4.4$

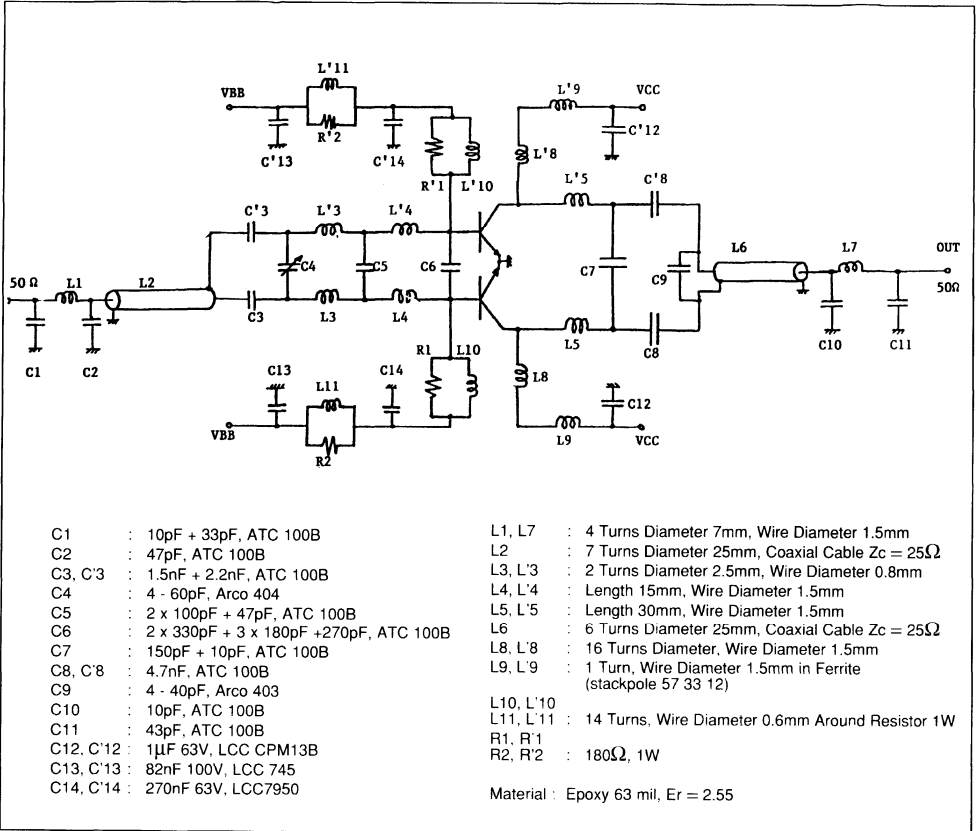
$P_{OUT} = 240 \text{ W}$   
 $V_{CC} = 32 \text{ V}$



## PRINTED CIRCUIT BOARD LAYOUT

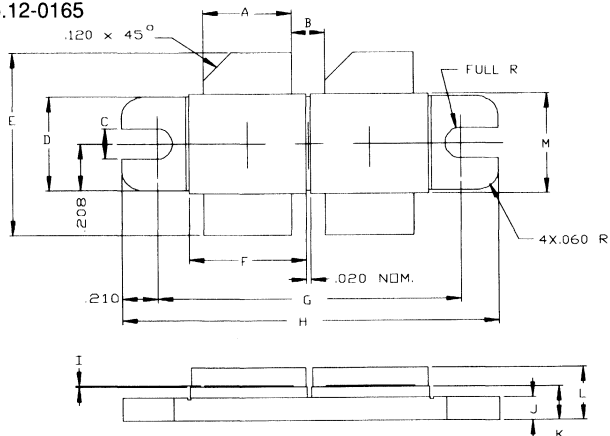


## TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0165



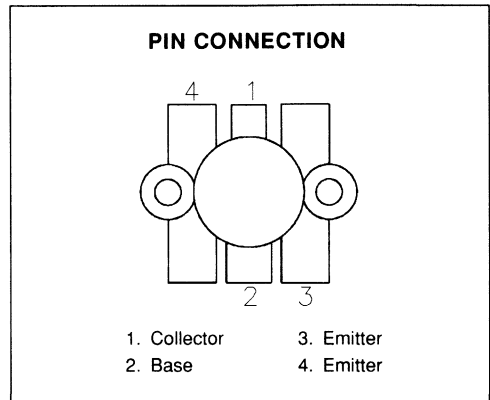
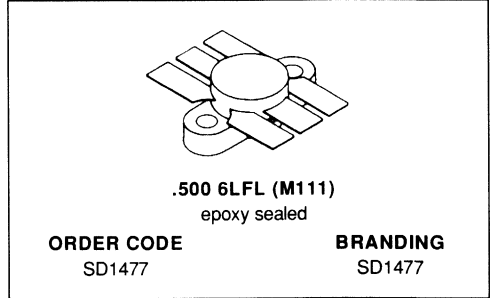
SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.373/9,47	.385/9,78	K	.135/3,43	.155/3,94
B	.122/3,10		L		.250/6,35
C	.125/3,18		M	.425/10,80	.435/11,05
D	.411/10,44	.421/10,69			
E	.825/20,96	.865/21,97			
F	.495/12,57	.505/12,83			
G	1.255/31,88	1.265/32,13			
H	1.675/42,55	1.685/42,80			
I	.002/0,05	.006/0,15			
J	.095/2,41	.105/2,67			





**RF & MICROWAVE TRANSISTORS  
 VHF MOBILE APPLICATIONS**

- 175 MHz
- 12.5 VOLTS
- COMMON EMITTER
- $P_{OUT} = 100 \text{ W MIN. WITH } 6.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1477 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF FM communications. This device utilizes diffused emitter resistors to withstand extremely high VSWR under rated operating conditions, and is internally input matched to optimize power gain and efficiency over the 136 - 175 MHz band.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{CES}$	Collector-Emitter Voltage	36	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	20	A
$P_{DISS}$	Power Dissipation	270	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.65	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

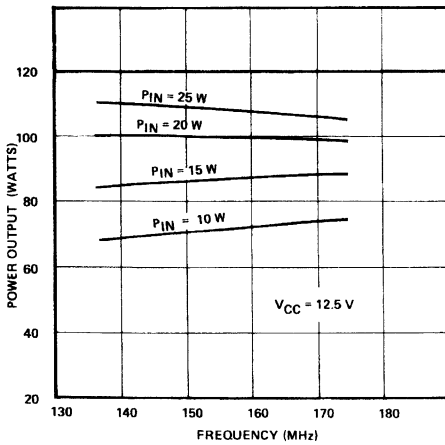
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	36	—	—	V
$BV_{CES}$	$I_C = 100mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 100mA$	$I_B = 0mA$	18	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 15V$	$I_E = 0mA$	—	—	15	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	10	—	—	—

**DYNAMIC**

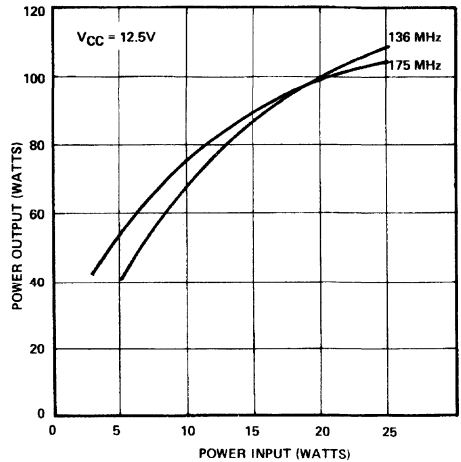
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 175\text{ MHz}$	$P_{IN} = 25\text{ W}$	$V_{CC} = 12.5\text{ V}$	100	—	—	W
$G_P$	$f = 175\text{ MHz}$	$P_{IN} = 25\text{ W}$	$V_{CC} = 12.5\text{ V}$	6.0	—	—	dB
$COB$	$f = 1\text{ MHz}$	$V_{CB} = 12.5\text{ V}$		—	350	—	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs FREQUENCY**

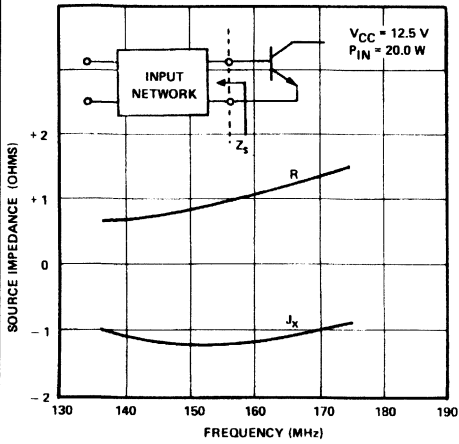


**POWER OUTPUT vs POWER INPUT**

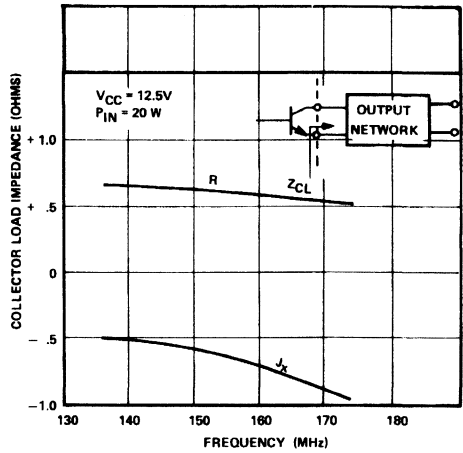


## IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

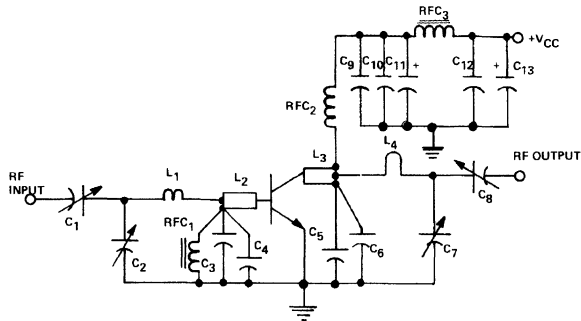
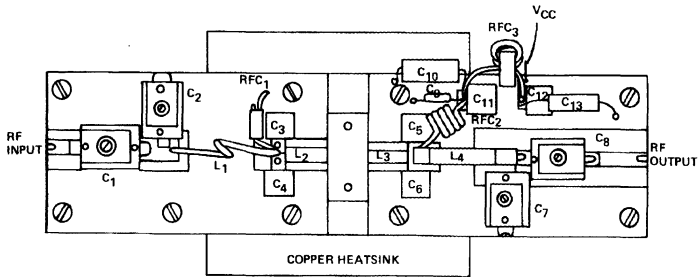


TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
175 MHz	$1.5 - j 0.9$	$0.5 - j 1.0$

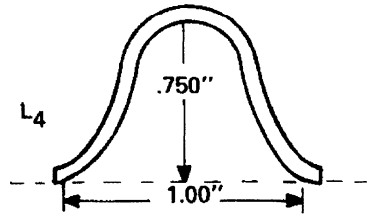
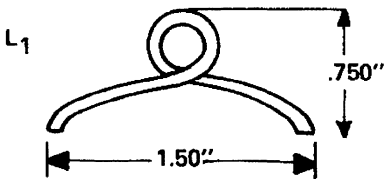
TEST CIRCUIT



- C1, C2 : Arco 462 5 - 80pF
- C3, C4 : Unelco 100pF, 350V
- C5, C6 : Unelco 120pF, 350V
- C7, C8 : Arco 463 9 - 180pF
- C9, C12 : Unelco 1000pF, 350V
- C10 : Erie .15μF, 200V Red Cap
- C11 : 25μF, 25V Electrolytic
- C13 : 10μF, 25V Electrolytic

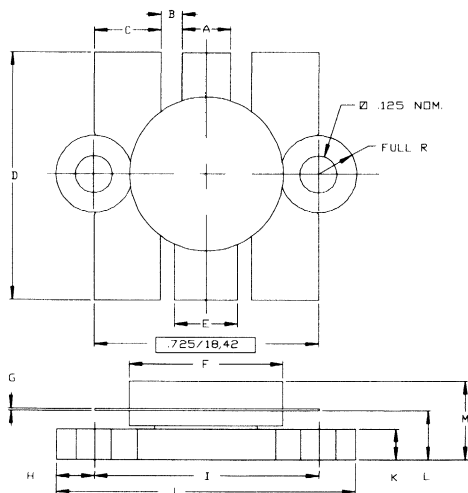
- L1 : 1 Turn, #12, 1/4" I.D.
- L2, L3 : 1/2' 50Ω Stripline (.180" Wide)
- L4 : 1/8" Thick Copper Strap 1/4" Wide
- RFC1 : 1 1/2 Turns on Ferroxcube VK200/19-B
- RFC2 : 4 Turn #16 Enamel, 3/8" I.D., 3/8" Long
- RFC3 : 4 Turns #16 Enamel on T50-2 Torroid

Board Material: 3M-K6098, 1/16" Thick



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0111

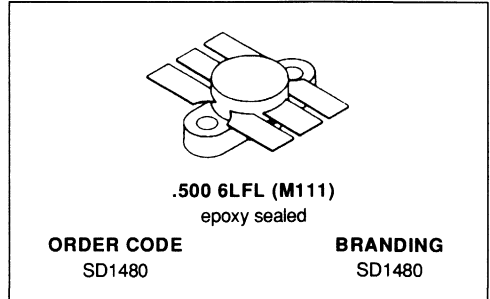
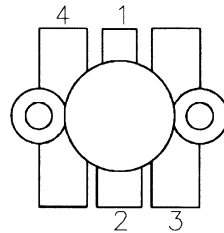


SGS-THOMSON MICROELECTRONICS		COND'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			



**RF & MICROWAVE TRANSISTORS  
 VHF APPLICATIONS**

- 136 - 175 MHz
- 28 VOLTS
- EFFICIENCY 55%
- COMMON EMITTER
- GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- $P_{OUT} = 125 \text{ W MIN. WITH } 9.2 \text{ dB GAIN}$


**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Emitter |

**DESCRIPTION**

The SD1480 is a common emitter 28 V Class C epitaxial silicon NPN planar transistor designed primarily for VHF communications applications. This internally matched device incorporates diffused emitter ballasting resistors and provides high gain and stable operation across the entire 136 - 175 MHz VHF communications band.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	36	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	20	A
$P_{DISS}$	Power Dissipation	270	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.65	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 100mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 100mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{CEO}$	$I_C = 100mA$	$I_B = 0mA$	35	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 30V$	$I_E = 0mA$	—	—	15	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 5A$	20	—	200	—

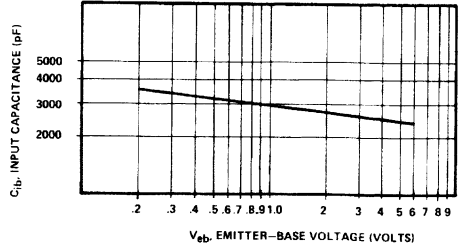
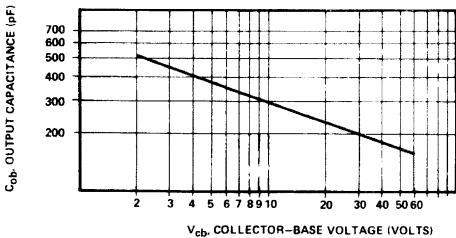
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 138 - 175 MHz$	$P_{IN} = 15 W$	$V_{CE} = 28 V$	125	—	—	W
$G_P$	$f = 138 - 175 MHz$	$P_{IN} = 15 W$	$V_{CE} = 28 V$	9.2	—	—	dB
$\eta_c$	$f = 138 - 175 MHz$	$P_{IN} = 15 W$	$V_{CE} = 28 V$	55	—	—	%
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	—	250	pF

TYPICAL PERFORMANCE

**OUTPUT CAPACITANCE vs COLLECTOR BASE VOLTAGE**

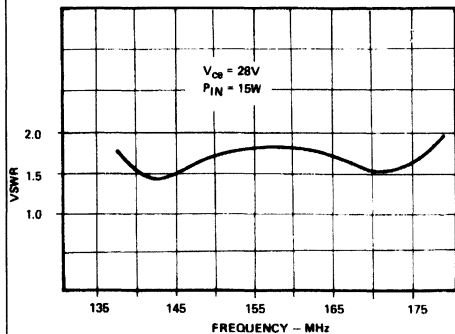
**INPUT CAPACITANCE vs EMITTER BASE VOLTAGE**



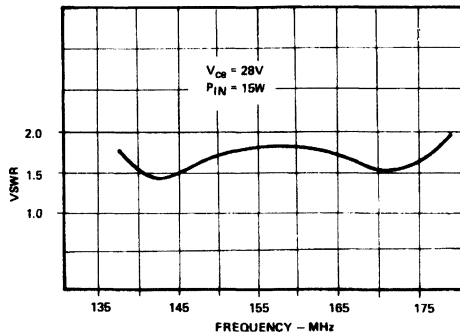


## TYPICAL PERFORMANCE (cont'd)

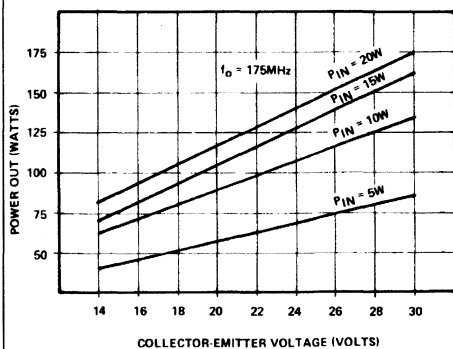
POWER OUTPUT vs POWER INPUT



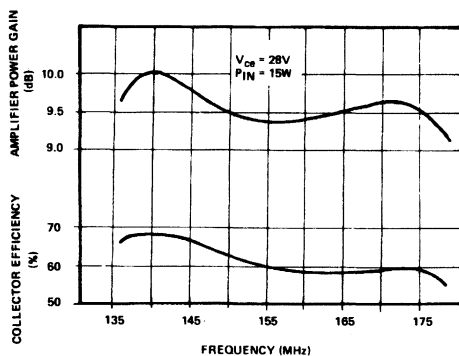
INPUT VSWR vs FREQUENCY



POWER OUTPUT vs COLLECTOR EMITTER VOLTAGE

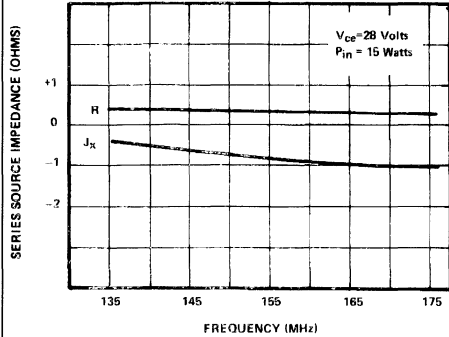


POWER GAIN &amp; COLLECTOR EFFICIENCY vs FREQUENCY

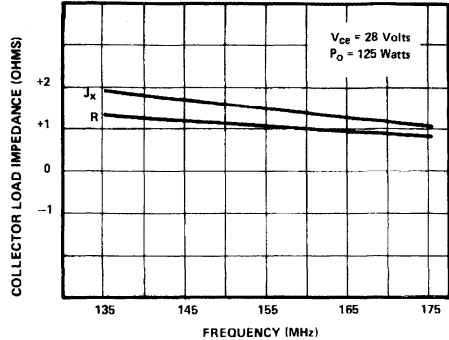


IMPEDANCE DATA

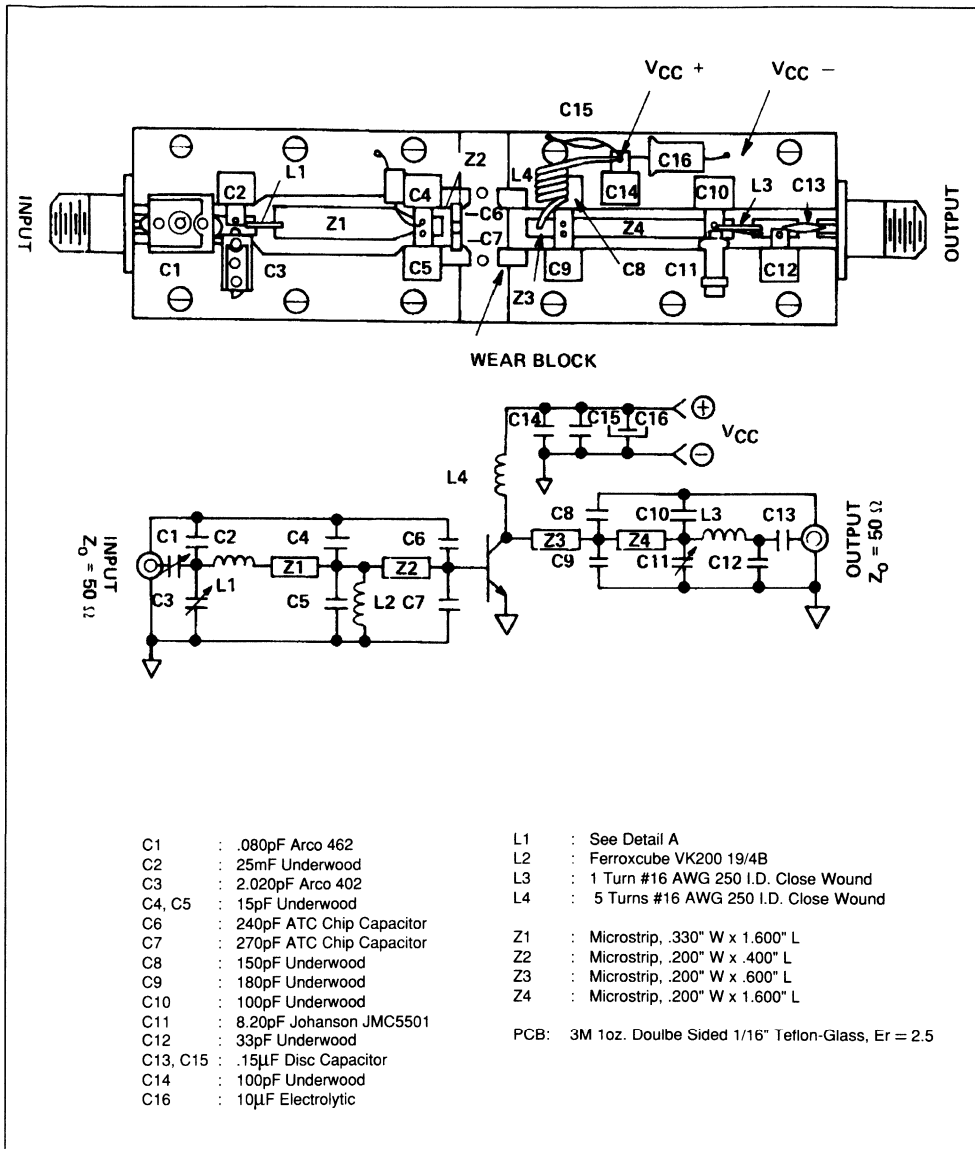
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

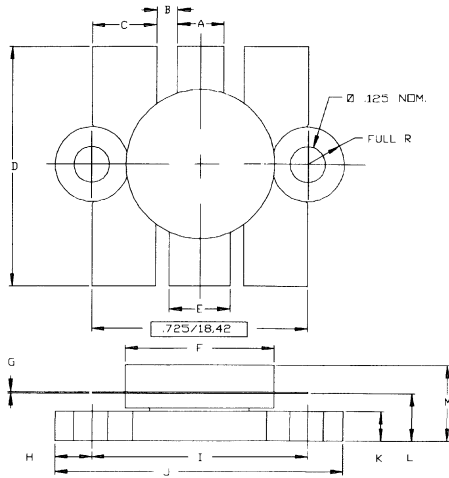


## TEST CIRCUIT



PACKAGE MECHANICAL DATA

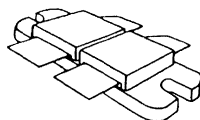
Ref.: Dwg. No.12-0111



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			

**RF & MICROWAVE TRANSISTORS  
 FM BROADCAST APPLICATIONS**

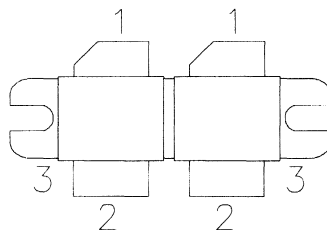
- 88 - 108 MHz
- 28 VOLTS
- EFFICIENCY 60%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 300 \text{ W MIN. WITH } 10 \text{ dB GAIN}$



**2 x .437 x .450 2LFL (M175)**  
 epoxy sealed

**ORDER CODE**  
 SD1483

**BRANDING**  
 SD1483

**PIN CONNECTION**


1. Collector      3. Emitter  
 2. Base

**DESCRIPTION**

The SD1483 is a 28 V gold metallized epitaxial silicon NPN planar transistor designed for VHF FM broadcast transmitters.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{CES}$	Collector-Emitter Voltage	60	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_C$	Device Current	25	A
$P_{DISS}$	Power Dissipation	380	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 50 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.45	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 100mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 100mA$	$V_{BE} = 0V$	60	—	—	V
$BV_{CEO}$	$I_C = 100mA$	$I_B = 0mA$	30	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$	3.0	—	—	V
$I_{CBO}$	$V_{CB} = 30V$	$I_E = 0mA$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	120	—

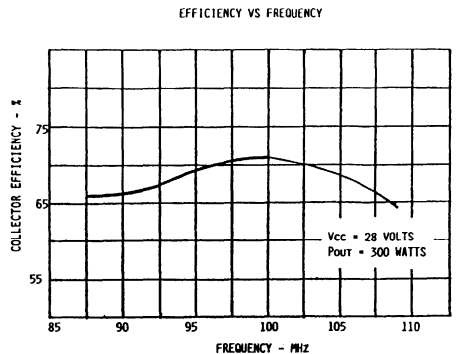
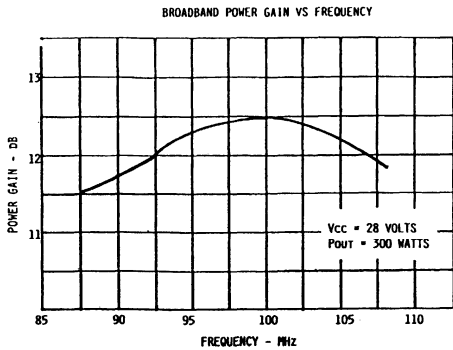
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 108\text{ MHz}$	$P_{IN} = 30\text{ W}$	$V_{CE} = 28\text{ V}$	300	—	—	W
$G_P$	$f = 108\text{ MHz}$	$P_{IN} = 30\text{ W}$	$V_{CE} = 28\text{ V}$	10	—	—	dB
$\eta_C$	$f = 108\text{ MHz}$	$P_{IN} = 30\text{ W}$	$V_{CE} = 28\text{ V}$	60	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 28\text{ V}$		—	130	—	pF

**TYPICAL PERFORMANCE**

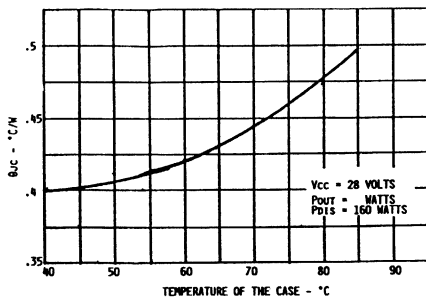
**POWER GAIN vs FREQUENCY**

**COLLECTOR EFFICIENCY vs FREQUENCY**

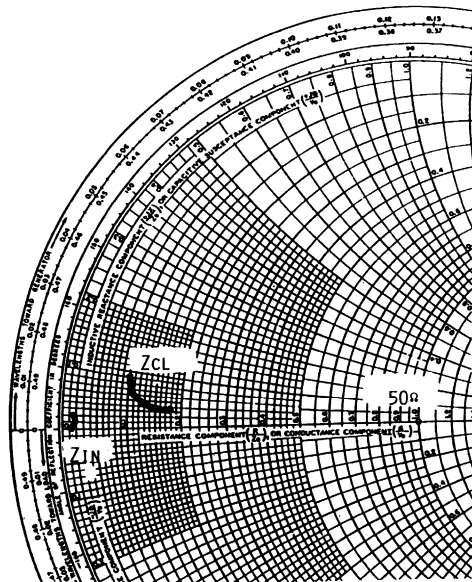


## TYPICAL PERFORMANCE (cont'd)

## THERMAL RESISTANCE vs CASE TEMPERATURE

IR SCAN HOT SPOT  $\theta_{JC}$  VS CASE TEMPERATURE

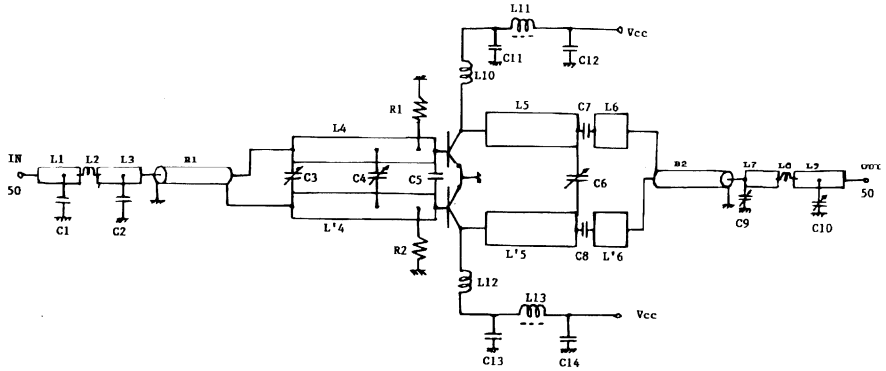
## IMPEDANCE DATA



FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
85 MHz	$0.82 - j 0.0$	$8.6 + j 1.37$
90 MHz	$0.93 - j 0.16$	$7.1 + j 1.5$
100 MHz	$0.98 - j 0.33$	$5.8 + j 2.7$
110 MHz	$0.93 - j 0.79$	$5.7 + j 3.6$

$P_{OUT} = 300 \text{ W}$   
 $V_{CC} = 28 \text{ V}$

## TEST CIRCUIT



B1, B2 :  $Z_c = 25\Omega$  Coaxial Cable =  $\lambda_g/4$

C1 : 4 - 60pF Trimmer  
 C2 : 33pF ATC 100B  
 C3 : 24 - 200pF Trimmer  
 C4 : 270pF + 380pF + 24 - 200pF Trimmer  
 C5 : 560pF ATC 100B  
 C6 : 24 - 200pF Trimmer  
 C7, C8 : 4.7nF ATC 100B  
 C9 : 2 x 22pF, ATC 100B + 1 - 10pF Trimmer  
 C10 : 27pF ATC 100B + 1 - 14pF Trimmer  
 C11, C12 : 1nF + 100nF + 47 $\mu$ F, 63V  
 C13, C14 : 1nF + 100nF + 47 $\mu$ F, 63V

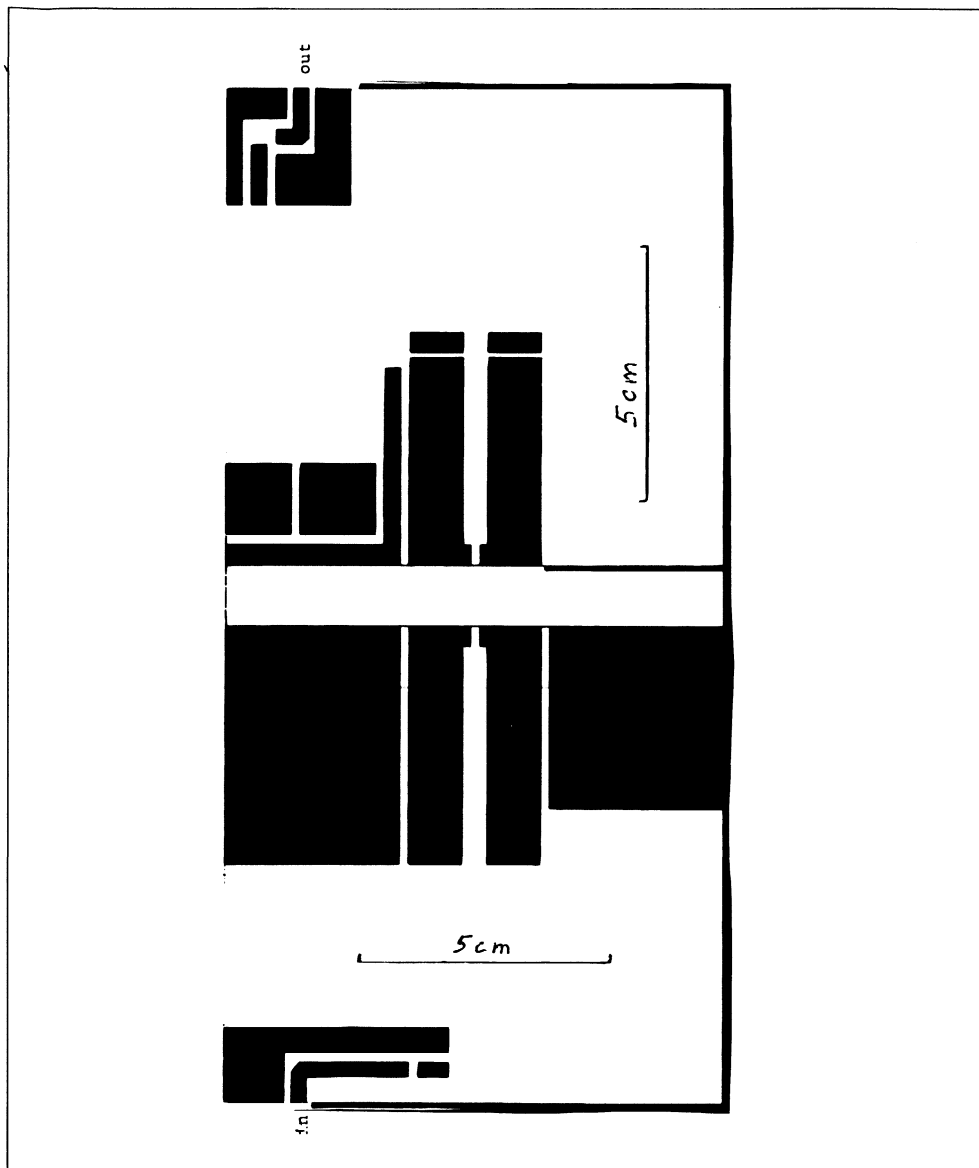
L1, L3 : Printed Line  $Z_c = 50\Omega$   
 L7, L9 : Inductor Length 32nH  
 L2 : Inductor Length 32nH  
 L4, L'4 : Printed Line Width 11mm, Length 47mm  
 L5, L'5 : Printed Line Width 11mm, Length 40mm  
 L6, L'6 : Printed Line Width 11mm, Length 4mm  
 L8 : Inductor Length 50nH  
 L10, L12 : Wire Diameter 1.5mm, Length 75nH  
 L11, L13 : Choke

R1, R2 : 6.2 $\Omega$  Sfernice

Material: Epoxy 63 mils  $E_r = 2.55$

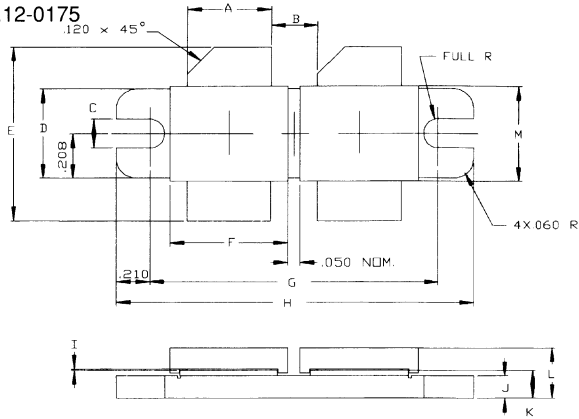


PRINTED CIRCUIT BOARD LAYOUT



## PACKAGE MECHANICAL DATA

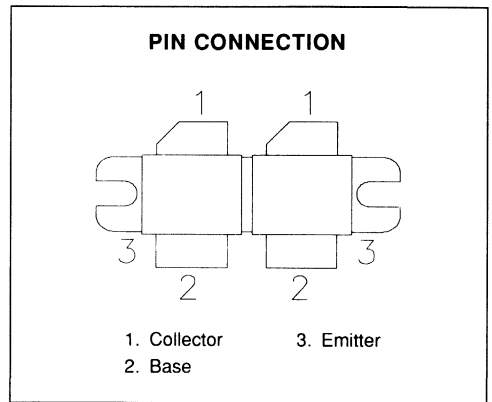
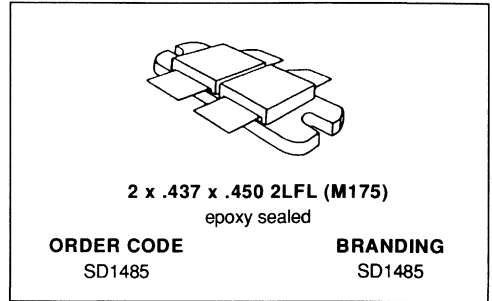
Ref.: Dwg. No.12-0175



SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.373/9,47	.385/9,78	K	.115/2,92	.135/3,43
B	.190/4,83		L		.250/6,35
C	.125/3,18		M	.445/11,30	.455/11,56
D	.411/10,44	.421/10,69			
E	.825/20,96	.865/21,97			
F	.525/13,34	.535/13,59			
G	1.255/31,88	1.265/32,13			
H	1.675/42,55	1.685/42,80			
I	.002/0,05	.006/0,15			
J	.095/2,41	.105/2,67			

**RF & MICROWAVE TRANSISTORS  
 TV/LINEAR APPLICATIONS**

- 170 - 230 MHz
- 32 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- CLASS AB PUSH PULL
- INTERNAL INPUT MATCHING
- HIGH SATURATED POWER CAPABILITY
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- $P_{OUT} = 200$  W MIN. WITH 11.0 dB GAIN


**DESCRIPTION**

The SD1485 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in VHF and Band III television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	35	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_C$	Device Current	25	A
$P_{DISS}$	Power Dissipation	385	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 50 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.45	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**SD1485****ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{E}} = 0\text{mA}$	65	—	—	V
$BV_{\text{CER}}$	$I_{\text{C}} = 100\text{mA}$	$R_{\text{BE}} = 15\Omega$	60	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{B}} = 0\text{mA}$	35	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 20\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.0	—	—	V
$I_{\text{CES}}$	$V_{\text{CB}} = 32\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	10	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 4\text{A}$	20	—	70	—

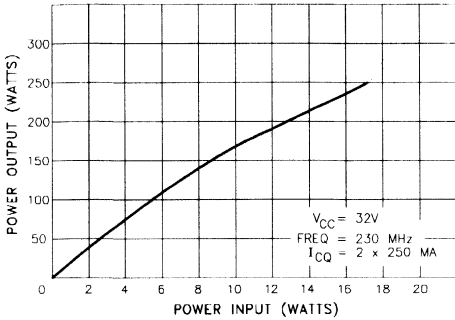
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}^*$	$f = 230\text{ MHz}$	$V_{\text{CE}} = 32\text{ V}$	$I_{\text{CQ}} = 2 \times 500\text{mA}$	200	—	—	W
$G_{\text{P}}$	$f = 230\text{ MHz}$	$V_{\text{CE}} = 32\text{ V}$	$I_{\text{CQ}} = 2 \times 500\text{mA}$	11	—	—	dB
$\eta_{\text{C}}$	$f = 230\text{ MHz}$	$V_{\text{CE}} = 32\text{ V}$	$I_{\text{CQ}} = 2 \times 500\text{mA}$	50	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		—	130	—	pF

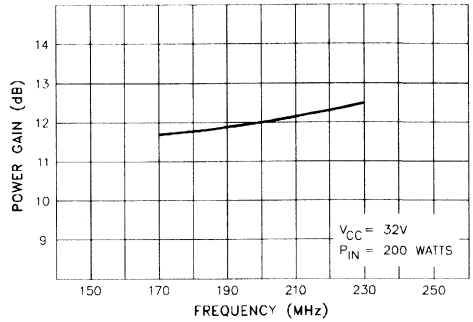
Note: \*1 dB Compression

## TYPICAL PERFORMANCE

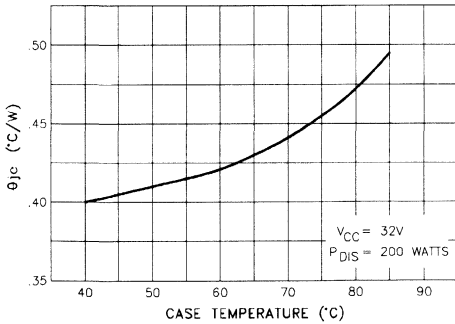
POWER OUTPUT vs POWER INPUT



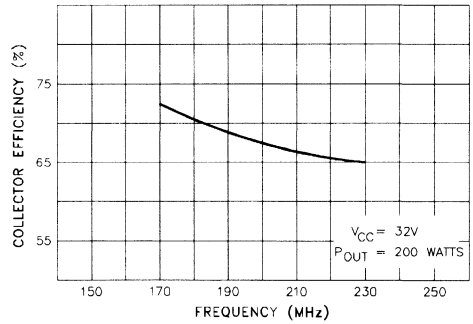
BROADBAND POWER GAIN vs FREQUENCY



THERMAL RESISTANCE vs CASE TEMPERATURE

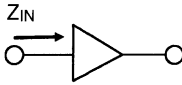


COLLECTOR EFFICIENCY vs FREQUENCY

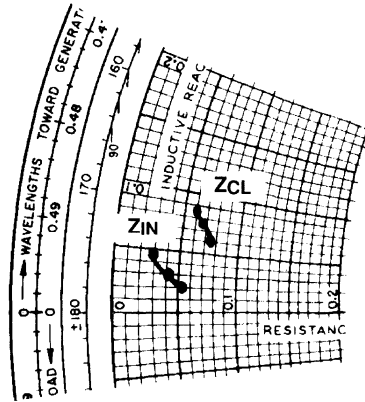
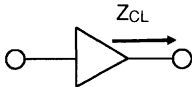


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



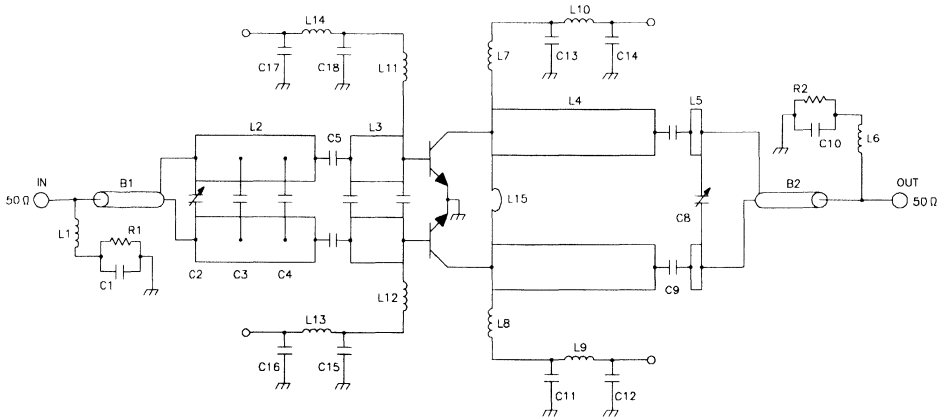
TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)*	Z <sub>CL</sub> (Ω)**
170 MHz	2.7 + j 1.0	3.75 + j 3.0
200 MHz	2.1 + j 1.5	3.4 + j 3.7
230 MHz	1.4 + j 2.2	3.0 + j 4.1

\* Base to Base  
 \*\* Collector to Collector  
 P<sub>OUT</sub> = 200 W  
 V<sub>CC</sub> = 32 V

## TEST CIRCUIT



B1, B2 : Coaxial Cable  $Z_c = 25\Omega$ ;  $\lambda_g/4$  @ 200MHz

C1, C10 : 1nF ATC 100B

C2 : 18pF ATC 100B + 0 - 20pf Trimmer

C3 : 15pF ATC 100B

C4 : 33pF ATC 100B

C5 : 470pF ATC 100B

C6 : 47pF ATC 100B

C7 : 150pF ATC 100B

C8 : 18pF + 0 - 20pF Trimmer

C9 : 2 x 220pF ATC 100B

C11, C12

C13, C14 : 1.5nF ATC 100B + 100nF + 100 $\mu$ F, 63V

C15, C16

C17, C18 : 1.5nF ATC 100B + 100nF + 47 $\mu$ F, 63V

L1, L6 : 470nH

L2 : Printed Line  $Z_c = 12.5\text{mm}$ , Length 32mm

L3 : Printed Line  $Z_c = 12.5\text{mm}$ , Length 14mm

L4 : Printed Line  $Z_c = 12.5\text{mm}$ , Length 43mm

L5 : Printed Line  $Z_c = 12.5\text{mm}$ , Length 32mm

L7, L8 : 3 Turns, Wire Diameter 1mm

L9, L10 : 5 Turns, Wire Diameter 1mm

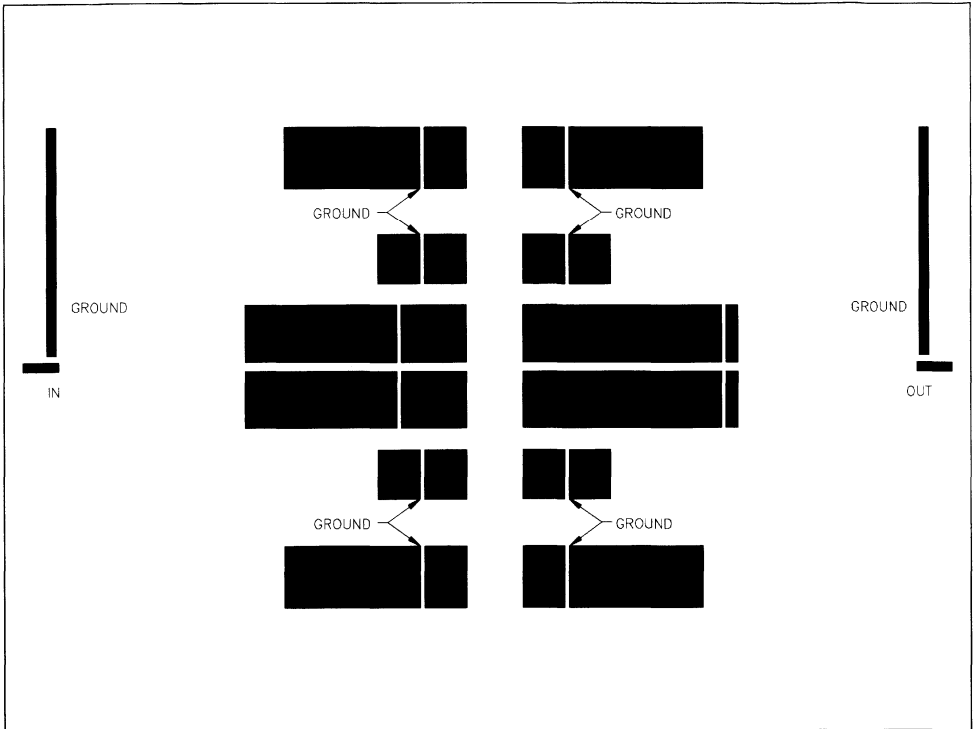
L11, L12

L13, L14 : 10 Turns, Wire Diameter 5mm

L15 : Wire Diameter 1mm, Length 13mm

Material: Teflon-Glass 30 mils Thick,  $\epsilon_r = 2.55$

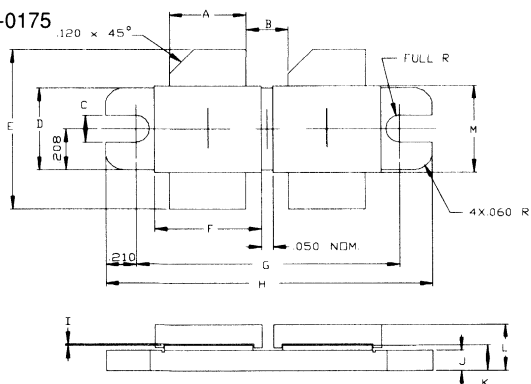
PRINTED CIRCUIT BOARD LAYOUT





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0175

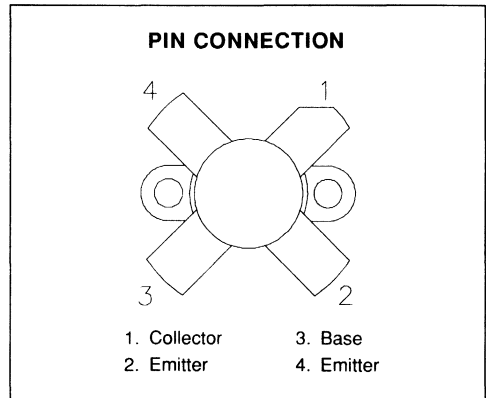
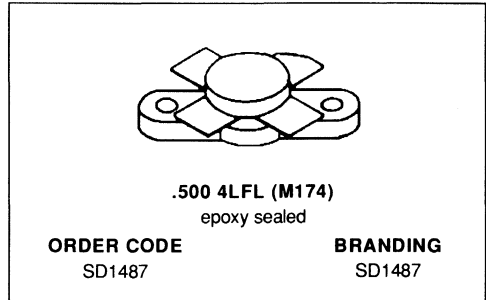


SGS-THOMSON MICROELECTRONICS		CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.373/9,47	.385/9,78	K	.115/2,92 135/3,43
B	.190/4,83		L	.250/6,35
C	.125/3,18		M	445/11,30 455/11,56
D	.411/10,44	.421/10,69		
E	.825/20,96	.865/21,97		
F	.525/13,34	.533/13,59		
G	1.255/31,88	1.265/32,13		
H	1.675/42,55	1.685/42,80		
I	.002/0,05	.006/0,15		
J	.095/2,41	.105/2,67		



**RF & MICROWAVE TRANSISTORS  
 HF SSB APPLICATIONS**

- 30 MHz
- 12.5 VOLTS
- IMD -30 dB
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 100 \text{ W MIN. WITH } 12.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1487 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for HF communications. This device utilizes state-of-the-art diffused emitter ballasting to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	18	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	20	A
$P_{DISS}$	Power Dissipation	290	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.6	$^{\circ}\text{C}/\text{W}$
---------------	----------------------------------	-----	-----------------------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 100mA	I <sub>E</sub> = 0mA	36	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 100mA	V <sub>BE</sub> = 0V	36	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 100mA	I <sub>B</sub> = 0mA	18	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 20mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 15V	I <sub>E</sub> = 0mA	—	—	20	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 5A	10	—	200	—

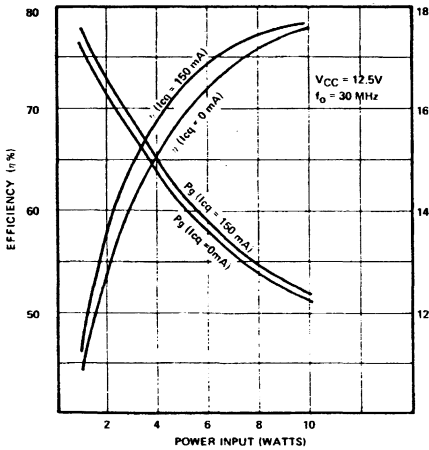
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 30 MHz	V <sub>CE</sub> = 12.5 V	I <sub>CQ</sub> = 150mA	100	—	—	W
GP	f = 30 MHz	V <sub>CE</sub> = 12.5 V	I <sub>CQ</sub> = 150mA	11	13	—	dB
IMD <sub>3</sub> *	P <sub>OUT</sub> = 100 W PEP	V <sub>CE</sub> = 12.5 V	I <sub>CQ</sub> = 150mA	—	—	-30	dBc
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 12.5 V		—	400	—	pF

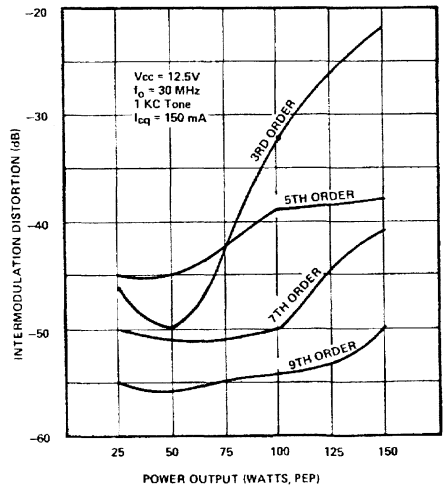
Note: \*f = 30 + 30.001MHz

TYPICAL PERFORMANCE

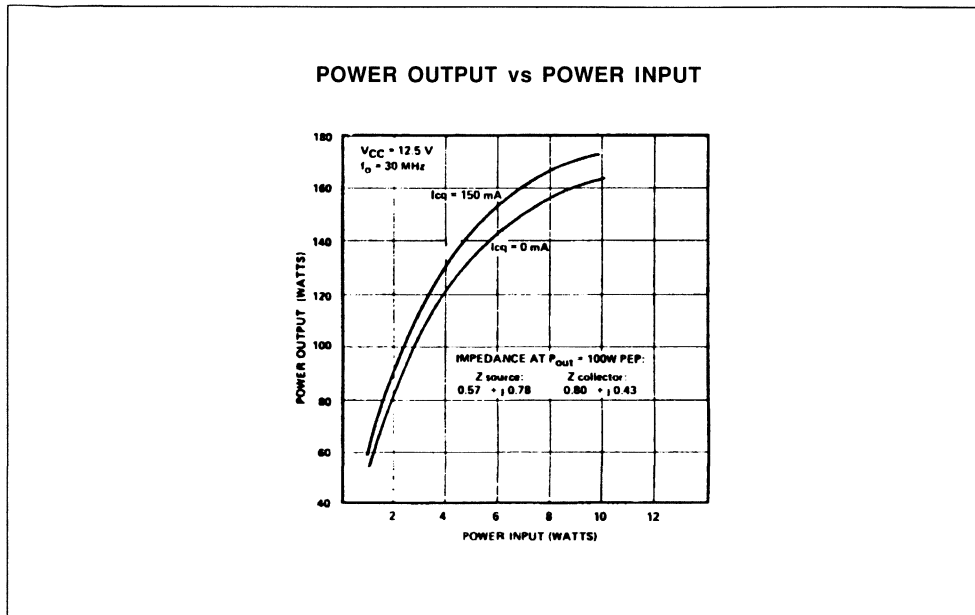
POWER GAIN & COLLECTOR EFFICIENCY vs POWER INPUT



IMD vs POWER OUTPUT, PEP



## TYPICAL PERFORMANCE (cont'd)

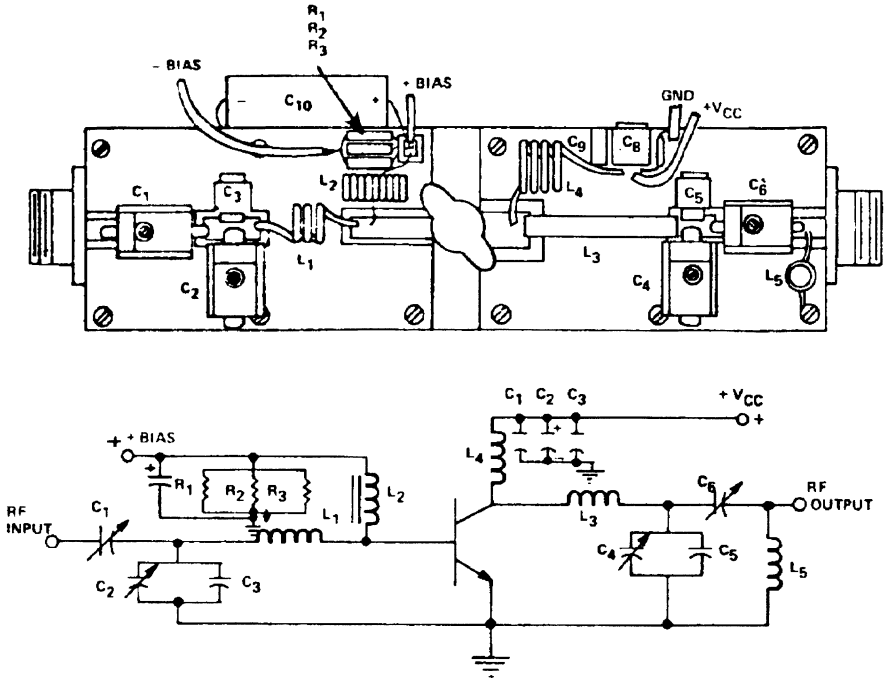


## IMPEDANCE DATA

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
30 MHz	$0.57 + j 0.78$	$0.80 + j 0.43$

$P_{OUT} = 100 \text{ W PEP}$   
 $V_{CE} = 12.5 \text{ V}$

## TEST CIRCUIT



C1 : 9 - 180pF Arco 463  
 C2 : 5 - 380pF Arco 465  
 C3 : 200pF Arco 465  
 C4, C6 : 170pF Arco 469  
 C7 : 0.1 $\mu$ F Ceramic Disc  
 C5, C8 : 1000pF Unelco  
 C9 : 10 $\mu$ F Electrolytic, 35Vdc  
 C10 : 1000 $\mu$ F Electrolytic, 35Vdc

L1 : 2 1/2 Turns, #14 AWG, I.D. Loose Wound  
 L2 : 16 Turns, #16 AWG, Enamelled Wire on  
 Micrometals Torroid #T-94

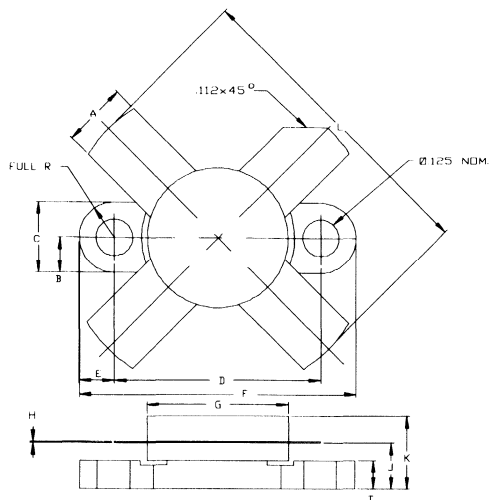
L3 : Copper Strap 1/4" Widht, Length 1 1/2,  
 Height 1/2"

L4 : 4 Turns, #16 AWG, Enamelled Wire 3/8" I.D.  
 L5 : 5 Turns, #18 AWG on 1/4" I.D. Coil Form  
 Length 1/2", Ferrite Slug

R1, R2,  
 R3 : 1.5 Ohm, 1 Watt Carbon

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0174



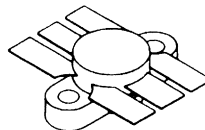
SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K		.280/7,11
B		.125/3,18	L		1.050/26,67
C	.245/6,22	.255/6,48			
D	.720/18,28	.730/18,54			
E		.125/3,18			
F	.970/24,64	.980/24,89			
G	.495/12,57	.505/12,83			
H	.003/0,08	.007/0,18			
I	.090/2,29	.110/2,79			
J	.160/4,06	.175/4,45			





**RF & MICROWAVE TRANSISTORS  
 UHF MOBILE APPLICATIONS**

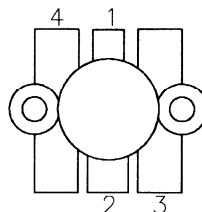
- 470 MHz
- 12.5 VOLTS
- EFFICIENCY 55%
- COMMON EMITTER
- $P_{OUT} = 38 \text{ W MIN. WITH } 5.8 \text{ dB GAIN}$



**.500 6LFL (M111)**  
 EPOXY SEALED

**ORDER CODE**  
 SD1488

**BRANDING**  
 SD1488

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

**DESCRIPTION**

The SD1488 is a 12.5 V Class C epitaxial silicon NPN planar transistor designed primarily for broad-band applications in the 450 - 512 MHz land mobile radio band. This device utilizes diffused emitter resistors to withstand infinite VSWR at rated operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	36	V
$V_{CEO}$	Collector-Emitter Voltage	16	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	8.0	A
$P_{DISS}$	Power Dissipation	117	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

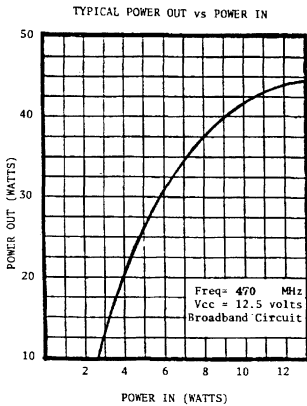
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 15mA$	$V_{BE} = 0V$	36	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	16	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CES}$	$V_{CE} = 12.5V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	20	—	—	—

**DYNAMIC**

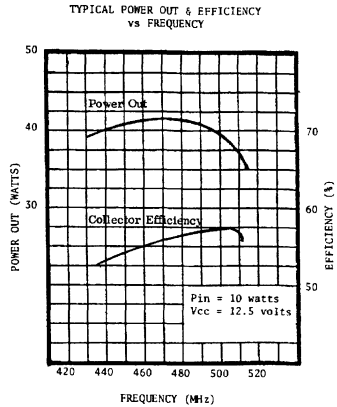
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 470\text{ MHz}$	$P_{IN} = 10.0\text{ W}$	$V_{CC} = 12.5\text{ V}$	38	—	—	W
$G_P$	$f = 470\text{ MHz}$	$P_{IN} = 10.0\text{ W}$	$V_{CC} = 12.5\text{ V}$	5.8	—	—	dB
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 12.5\text{ V}$		—	95	—	pF

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

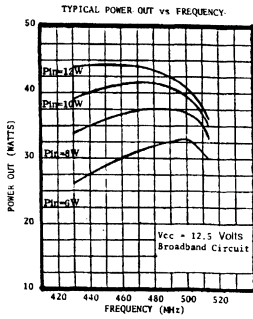


**POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**

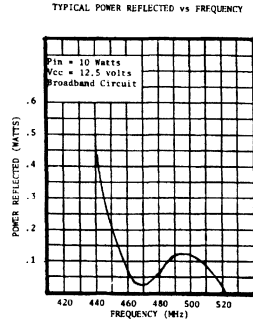


TYPICAL PERFORMANCE (cont'd)

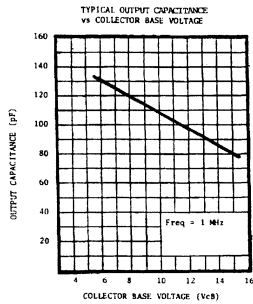
POWER OUTPUT vs FREQUENCY



POWER REFLECTED vs FREQUENCY

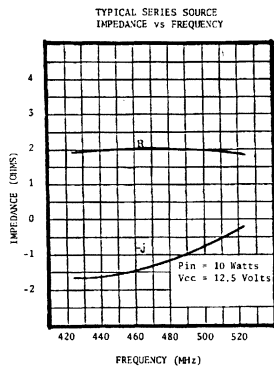


OUTPUT CAPACITANCE vs COLLECTOR BASE VOLTAGE

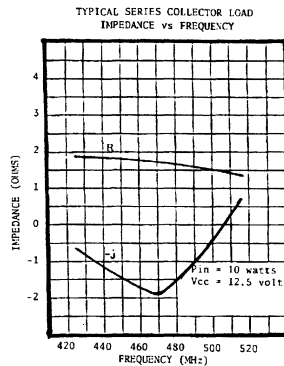


IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

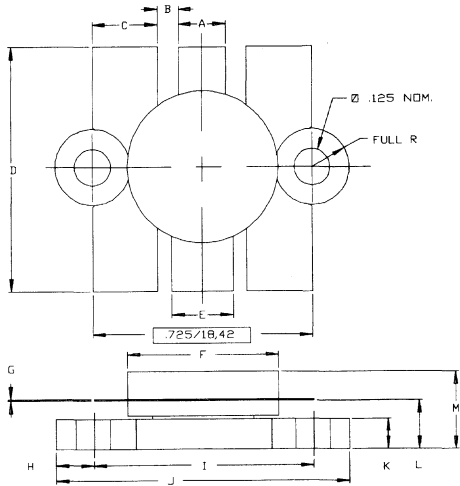


TYPICAL COLLECTOR LOAD IMPEDANCE



PACKAGE MECHANICAL DATA

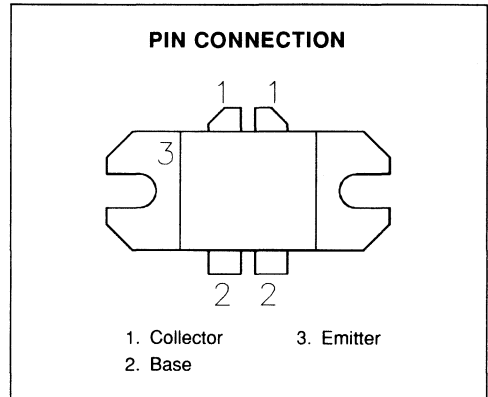
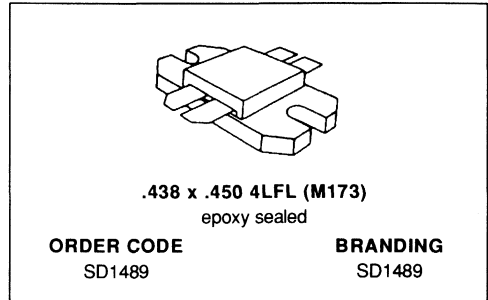
Ref.: Dwg. No.12-0111



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			

**RF & MICROWAVE TRANSISTORS  
 TV/LINEAR APPLICATIONS**

- 470 - 860 MHz
- 28 VOLTS
- CLASS AB PUSH PULL
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- GOLD METALLIZATION
- DIFFUSED EMITTER BALLAST RESISTORS
- COMMON EMITTER CONFIGURATION
- INTERNAL INPUT MATCHING
- $P_{OUT} = 50 \text{ W MIN. WITH } 6.5 \text{ dB GAIN}$


**DESCRIPTION**

The SD1489 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in UHF and Band IV, V television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_C$	Device Current	8	A
$P_{DISS}$	Power Dissipation	175	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	45	—	—	V
$BV_{CER}$	$I_C = 20mA$	$R_{BE} = 10\Omega$	40	—	—	V
$BV_{CEO}$	$I_C = 200mA$	$I_B = 0mA$	30	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.0	—	—	V
$I_{CEO}$	$V_{CE} = 28V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	10	—	80	—

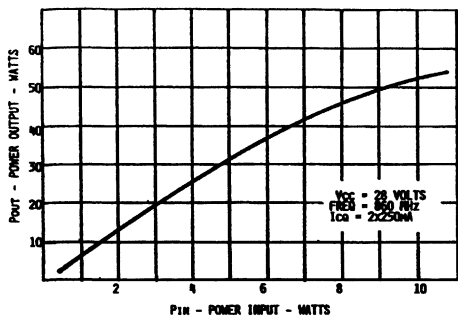
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 860 MHz$	$V_{CE} = 28 V$	$I_{CQ} = 2 \times 250 mA$	50	—	—	W
$G_P$	$f = 860 MHz$	$V_{CE} = 28 V$	$I_{CQ} = 2 \times 250 mA$	6.8	—	—	dB
$\eta_C$	$f = 860 MHz$	$V_{CE} = 28 V$	$I_{CQ} = 2 \times 250 mA$	—	45	—	%
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	70	—	pF

Note: Pulse Width = 10 $\mu$ Sec, Duty Cycle = 1%

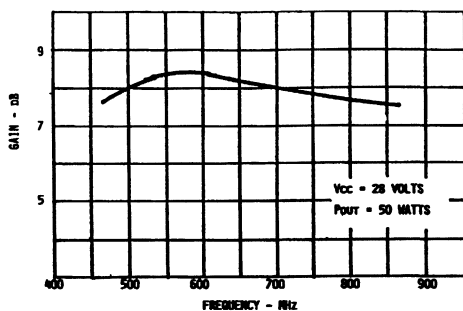
TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT



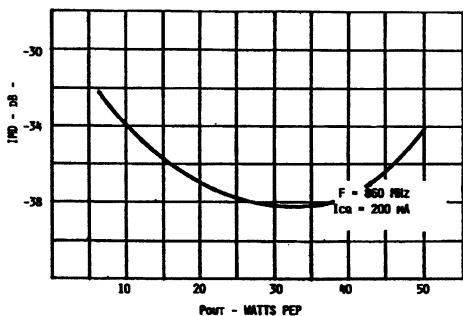
S88-SD1489-02

BROADBAND POWER GAIN vs FREQUENCY



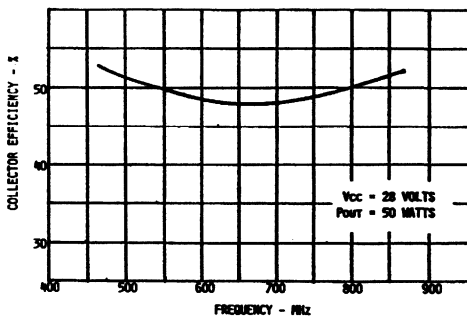
S88-SD1489-03

INTERMODULATION DISTORTION vs POWER OUTPUT



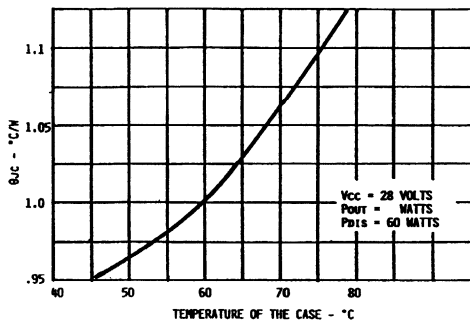
S88-SD1489-04

COLLECTOR EFFICIENCY vs FREQUENCY



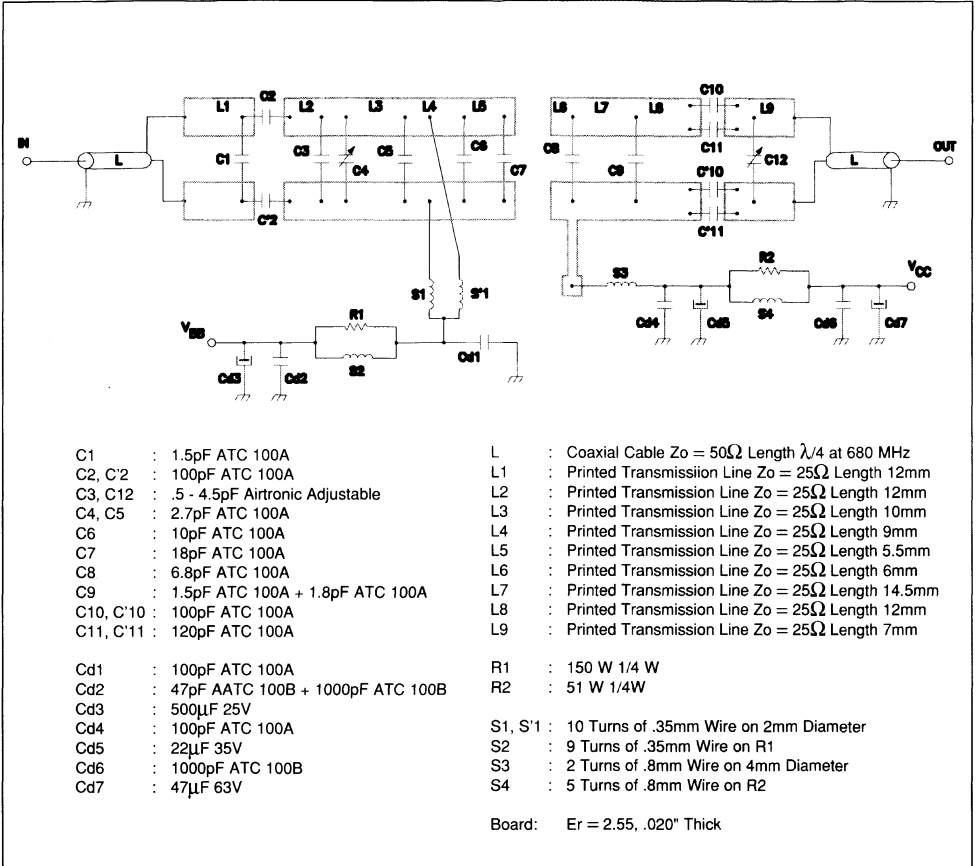
S88-SD1489-05

THERMAL RESISTANCE vs CASE TEMPERATURE

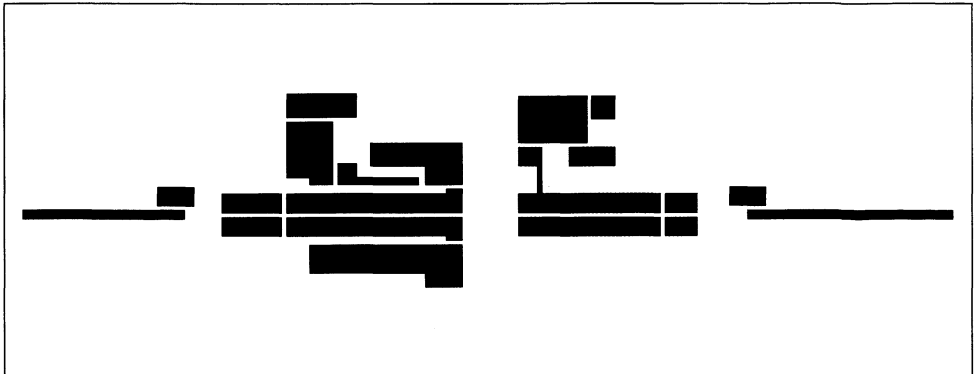


S88-SD1489-06

TEST CIRCUIT



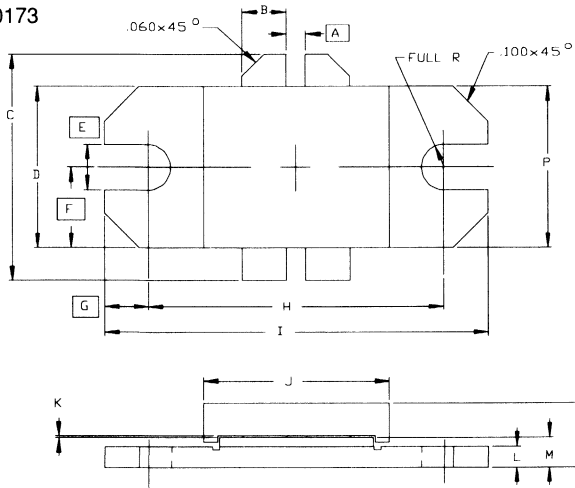
TEST CIRCUIT LAYOUT





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0173

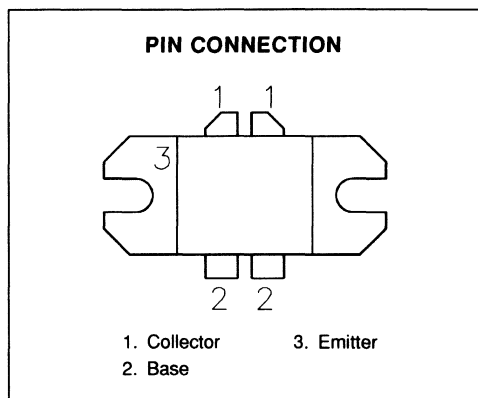
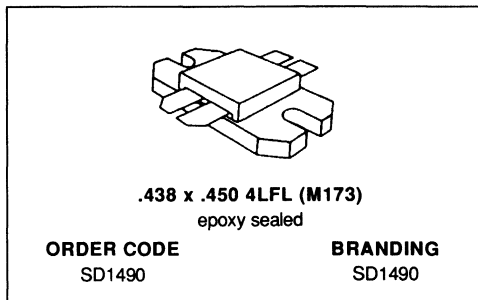


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.055/1,40		K	.002/0,05	.006/0,15
B	.120/3,05	.130/3,30	L	.055/1,40	.065/1,65
C	.785/19,94		M	.080/2,03	.095/2,41
D	.455/11,56	.465/11,81	N	.195/4,95	
E	.125/3,18		P	.455/11,56	.465/11,81
F	.230/5,84				
G	.128/3,25				
H	.838/21,28	.850/21,59			
I	1.095/27,81	1.105/28,07			
J	.525/13,34	.535/13,59			



**RF & MICROWAVE TRANSISTORS  
 TV/LINEAR APPLICATIONS**

- 470 - 860 MHz
- 28 VOLTS
- CLASS AB PUSH PULL
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- GOLD METALLIZATION
- DIFFUSED EMITTER BALLAST RESISTORS
- COMMON EMITTER CONFIGURATION
- INTERNAL INPUT MATCHING
- $P_{OUT} = 25 \text{ W MIN. WITH } 9.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1490 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in UHF and Band IV, V television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_C$	Device Current	8	A
$P_{DISS}$	Power Dissipation	135	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 50 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.3	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{E}} = 0\text{mA}$	45	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 200\text{mA}$	$I_{\text{B}} = 0\text{mA}$	30	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.0	—	—	V
$I_{\text{CEO}}$	$V_{\text{CE}} = 25\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 3\text{A}$	10	—	80	—

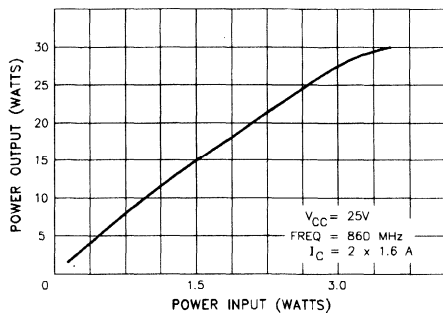
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$I_{\text{C}} = 3.2\text{ A}$	25	—	—	W
$G_{\text{P}}$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$I_{\text{C}} = 3.2\text{ A}$	8.0	—	—	dB
CMOD	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$P_{\text{REF}} = 25\text{ W}$	—	—	20	%
$\text{IMD}_3^*$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$P_{\text{REF}} = 25\text{ W}$	—	—	-45	dB
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		—	70	—	pF

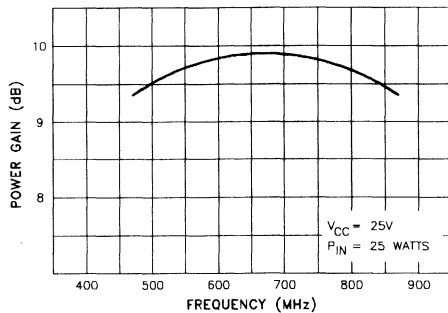
Note: \* 3 Tone Testing ( - 8, - 10, - 16 dB Relative to  $P_{\text{REF}}$  )

## TYPICAL PERFORMANCE

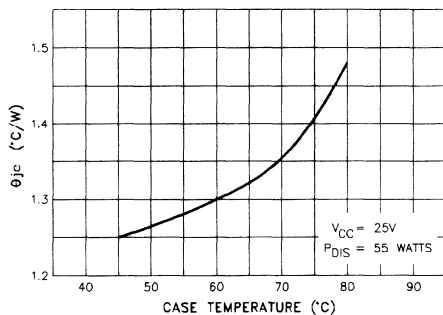
POWER OUTPUT vs POWER INPUT



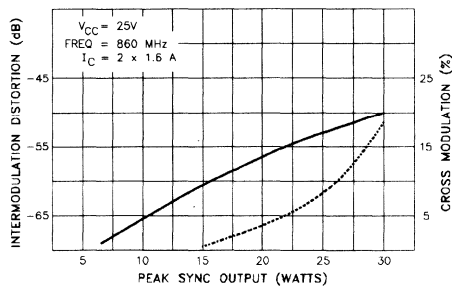
BROADBAND POWER GAIN vs FREQUENCY



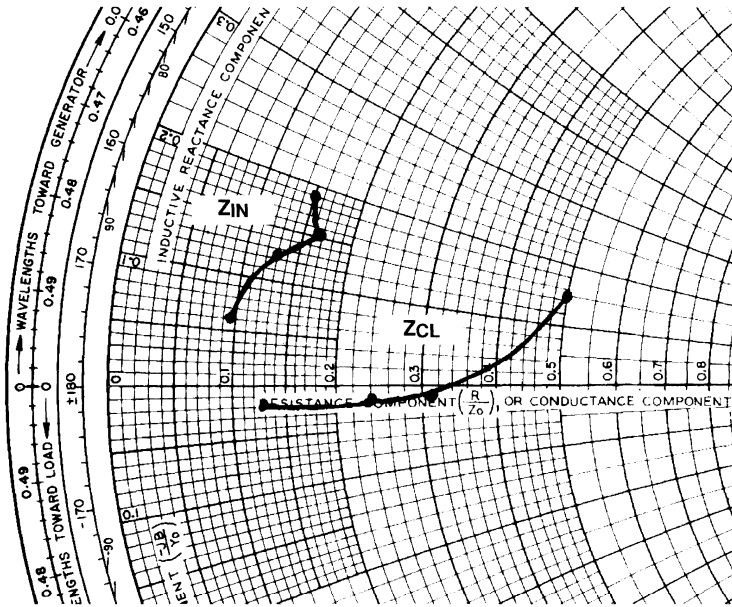
THERMAL RESISTANCE vs CASE TEMPERATURE



CROSS MODULATION &amp; INTERMODULATION vs PEAK SYNC OUTPUT



## IMPEDANCE DATA



FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
470 MHz	$7.5 + j 9.5$	$25 + j 7.5$
590 MHz	$8.2 + j 7.5$	$15.6 - j 0.13$
710 MHz	$6.6 + j 6.2$	$11.9 - j 0.28$
860 MHz	$4.7 + j 3.0$	$6.7 - j 0.38$

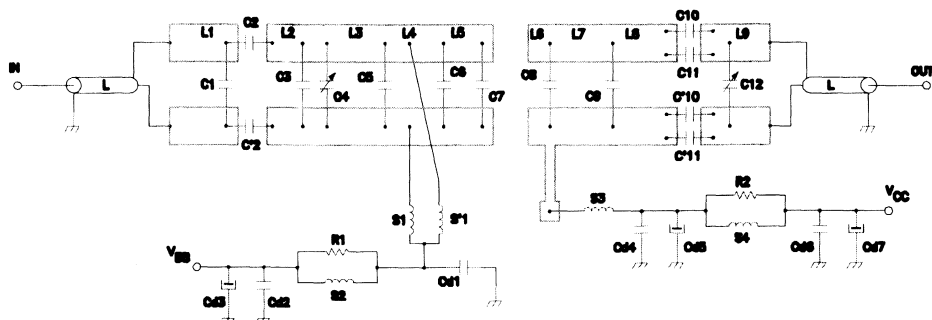
$P_{OUT} = 25$  W

$V_{CC} = 25$  V

$I_C = 3.2$  A

Normalized to 50 Ohms

## TEST CIRCUIT



C1	: 1.5pF ATC 100A
C2, C'2	: 100pF ATC 100A
C3, C12	: .5 - 4.5pF Airtronic Adjustable
C4, C5	: 2.7pF ATC 100A
C6	: 10pF ATC 100A
C7	: 18pF ATC 100A
C8	: 6.8pF ATC 100A
C9	: 1.5pF ATC 100A + 1.8pF ATC 100A
C10, C'10	: 100pF ATC 100A
C11, C'11	: 120pF ATC 100A

Cd1	: 100pF ATC 100A
Cd2	: 47pF AATC 100B + 1000pF ATC 100B
Cd3	: 500μF 25V
Cd4	: 100pF ATC 100A
Cd5	: 22μF 35V
Cd6	: 1000pF ATC 100B
Cd7	: 47μF 63V

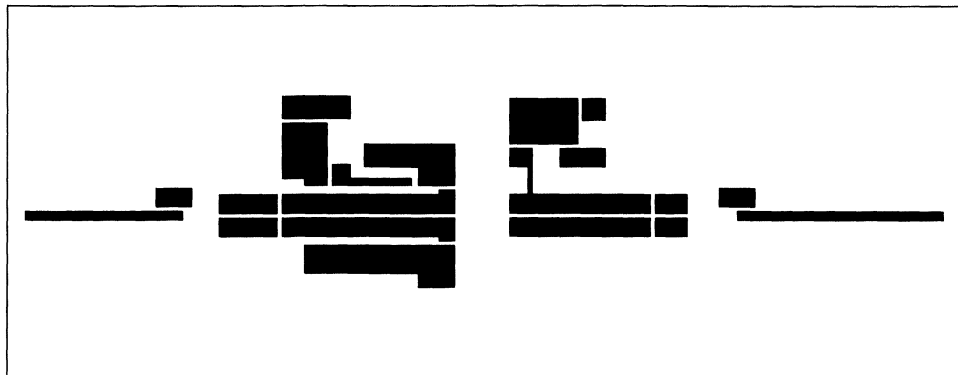
L	: Coaxial Cable $Z_0 = 50\Omega$ Length $\lambda/4$ at 680 MHz
L1	: Printed Transmission Line $Z_0 = 25\Omega$ Length 12mm
L2	: Printed Transmission Line $Z_0 = 25\Omega$ Length 12mm
L3	: Printed Transmission Line $Z_0 = 25\Omega$ Length 10mm
L4	: Printed Transmission Line $Z_0 = 25\Omega$ Length 9mm
L5	: Printed Transmission Line $Z_0 = 25\Omega$ Length 5.5mm
L6	: Printed Transmission Line $Z_0 = 25\Omega$ Length 6mm
L7	: Printed Transmission Line $Z_0 = 25\Omega$ Length 14.5mm
L8	: Printed Transmission Line $Z_0 = 25\Omega$ Length 10mm
L9	: Printed Transmission Line $Z_0 = 25\Omega$ Length 7mm

R1	: 150 W 1/4 W
R2	: 51 W 1/4W

S1, S'1	: 10 Turns of .35mm Wire on 2mm Diameter
S2	: 9 Turns of .35mm Wire on R1
S3	: 2 Turns of .8mm Wire on 4mm Diater
S4	: 5 Turns of .8mm Wire on R2

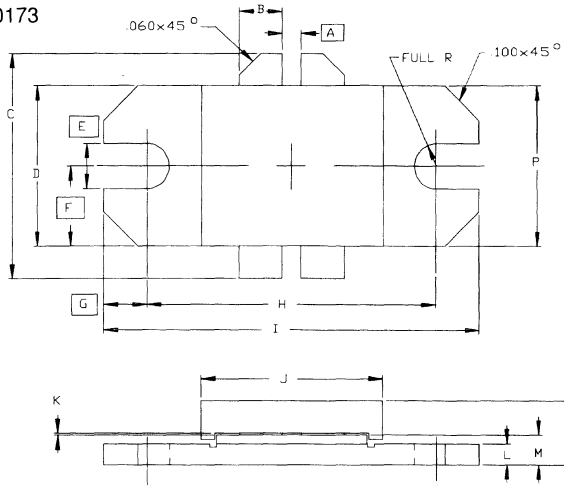
Board:  $E_r = 2.55, .020"$  Thick

## TEST CIRCUIT LAYOUT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0173

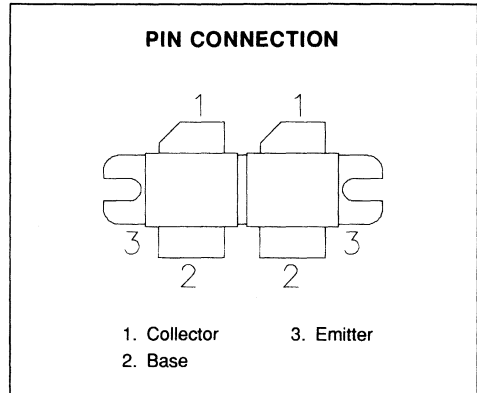
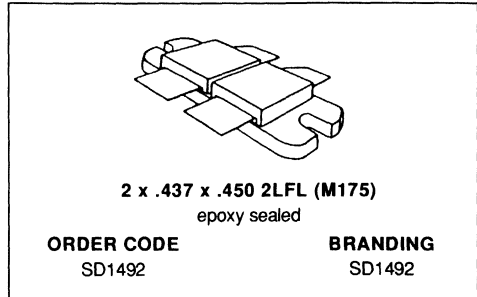


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.055/1,40		K	.002/0,05	.006/0,15
B	.120/3,05	.130/3,30	L	.055/1,40	.065/1,65
C		.785/19,94	M	.080/2,03	.095/2,41
D	.455/11,56	.465/11,81	N		.195/4,95
E	.125/3,18		P	.455/11,56	.465/11,81
F	.230/5,84				
G	.128/3,25				
H	.838/21,28	.850/21,59			
I	1.095/27,81	1.105/28,07			
J	.525/13,34	.535/13,59			



**RF & MICROWAVE TRANSISTORS  
 TV/LINEAR APPLICATIONS**

- 470 - 860 MHz
- 28 VOLTS
- CLASS AB PUSH PULL
- DESIGNED FOR HIGH POWER CAPABILITY
- GOLD METALLIZATION
- DIFFUSED EMITTER BALLAST RESISTORS
- COMMON EMITTER CONFIGURATION
- INTERNAL INPUT MATCHING
- $P_{OUT} = 150 \text{ W MIN. WITH } 6.5 \text{ dB GAIN}$


**DESCRIPTION**

The SD1492 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in UHF and Band IV, V television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_C$	Device Current	25	A
$P_{DISS}$	Power Dissipation	310	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.55	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**SD1492****ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{E}} = 0\text{mA}$	60	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{B}} = 0\text{mA}$	30	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 50\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.0	—	—	V
$I_{\text{CES}}$	$V_{\text{CE}} = 28\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	10	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 3\text{A}$	15	—	70	—

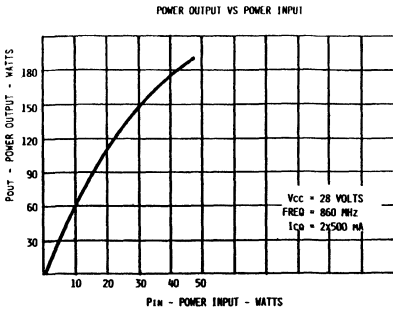
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}^*$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 28\text{ V}$	$I_{\text{CQ}} = 2 \times 500\text{ mA}$	150	—	—	W
$G_{\text{P}}^*$	$P_{\text{OUT}} = 150\text{ W}$	$V_{\text{CE}} = 28\text{ V}$	$I_{\text{CQ}} = 2 \times 500\text{ mA}$	6.5	—	—	dB
$\eta_{\text{c}}^*$	$P_{\text{OUT}} = 150\text{ W}$	$V_{\text{CE}} = 28\text{ V}$	$I_{\text{CQ}} = 2 \times 500\text{ mA}$	45	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		—	—	100	pF

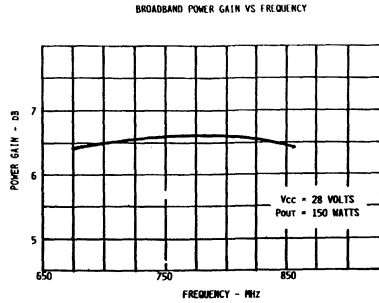
Note: \* 1 dB Compression Point

TYPICAL PERFORMANCE

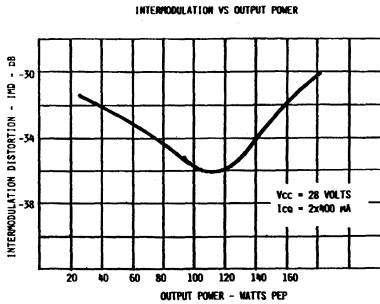
POWER OUTPUT vs POWER INPUT



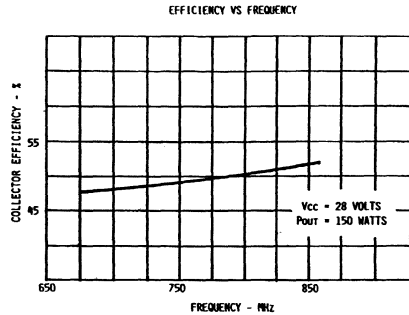
BROADBAND POWER GAIN vs FREQUENCY



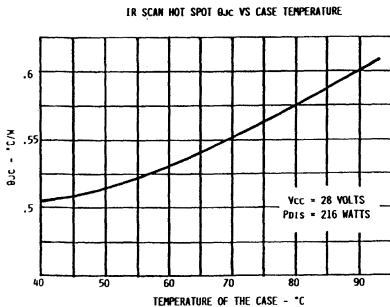
INTERMODULATION DISTORTION vs POWER OUTPUT



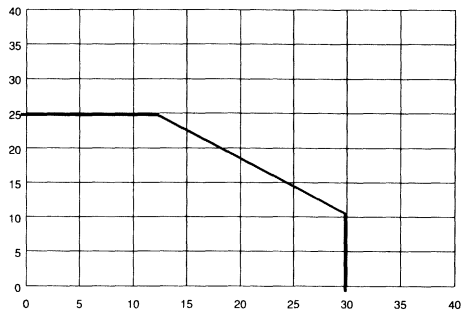
COLLECTOR EFFICIENCY vs FREQUENCY



THERMAL RESISTANCE vs CASE TEMPERATURE

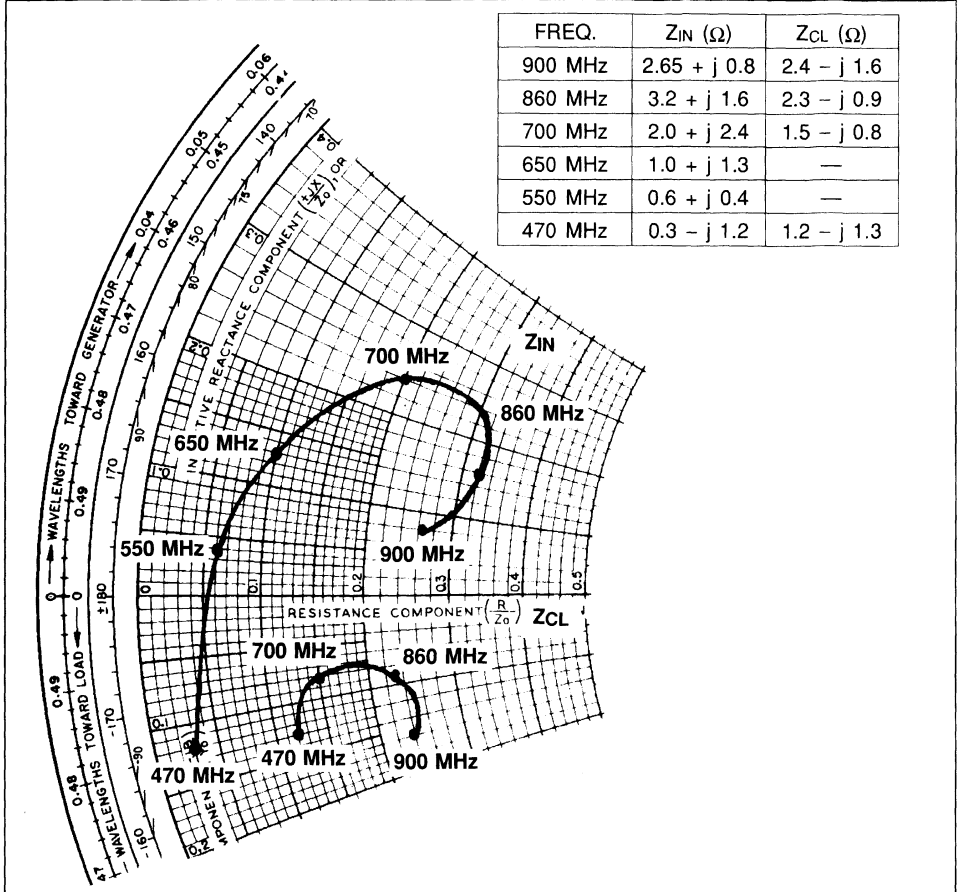


SAFE OPERATING AREA

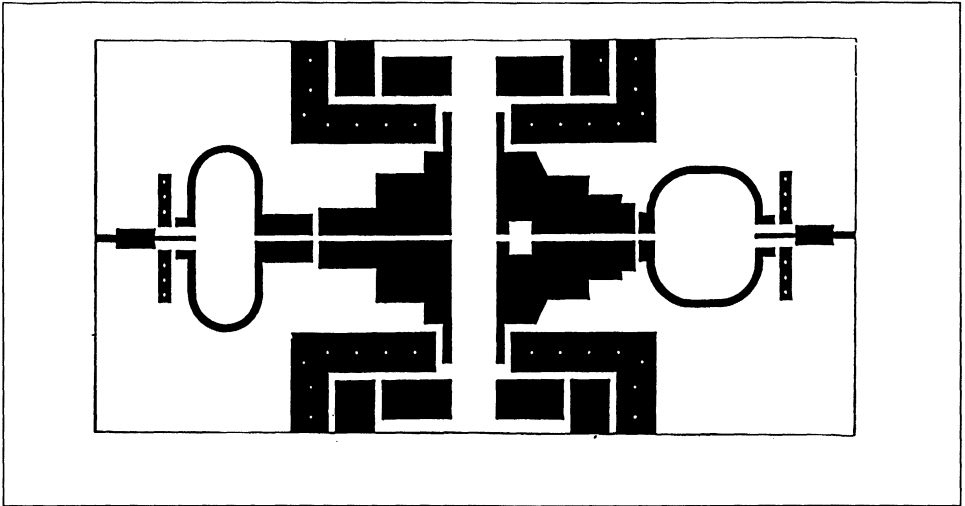


IMPEDANCE DATA

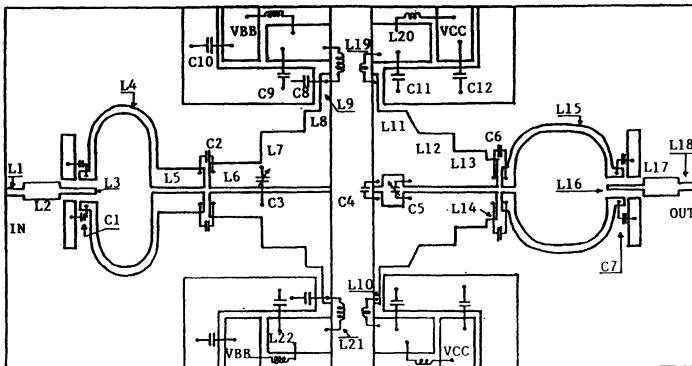
FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
900 MHz	2.65 + j 0.8	2.4 - j 1.6
860 MHz	3.2 + j 1.6	2.3 - j 0.9
700 MHz	2.0 + j 2.4	1.5 - j 0.8
650 MHz	1.0 + j 1.3	—
550 MHz	0.6 + j 0.4	—
470 MHz	0.3 - j 1.2	1.2 - j 1.3



## PHOTOMASTER OF TEST CIRCUIT



## TEST CIRCUIT



B1, B2 : Coaxial Cable 25, 43mm

C1, C2

C6, C7 : 330pF, ATC 100B

C3 : .8 - 8pF Johanson Gigatrim

C4 : 4.7pF + 3.9pF, ATC 100B

C5 : 3.9pF + 1.7pF, ATC 100B + .8 - 8pF Johanson Gigatrim

C8 : 120pF, ATC 100B

C9 : 1.5nF, ATC 100B

C10 : 10nF + 47μF, 63V

C11 : 1.5nF, ATC 100B + 10nF

C12 : 470pF + 1.5nF, ATC 100B + 100μF, 63V

Substrate: Teflon Glass Er = 2.55, 30Mils

L1, L18 : Printed Line 50Ω

L2, L17 : Printed Line 26.7Ω, 10mm

L3, L16 : Printed Line 60Ω, 10.5mm

L4, L15 : Printed Line 50Ω, 43mm

L5 : Printed Line 25Ω, 13.5mm

L6 : Printed Line 10.5Ω, 12.5mm

L7 : Printed Line 10.5Ω, 12.5mm

L8 : Printed Line 8Ω, 7.5mm

L9, L10 : Printed Line 50Ω, 10mm

L11 : Printed Line 9.5Ω, 10.5mm

L12 : Printed Line 21Ω, 15mm

L13 : Printed Line 15.5Ω, 8.5mm

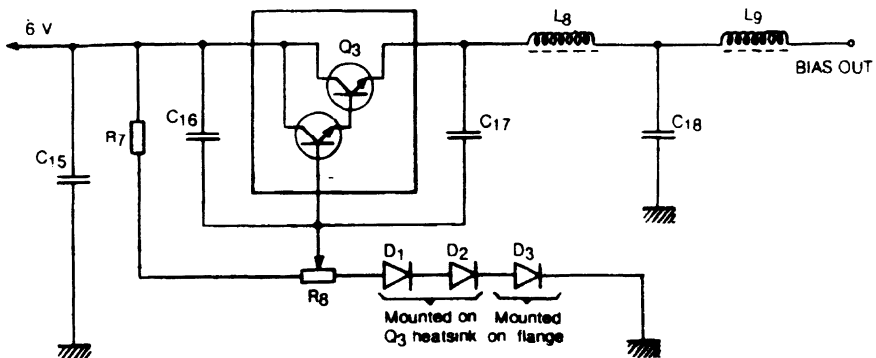
L14 : Printed Line 19Ω, 3.5mm

L19 : 2 Turns, #16 AWG

L20 : 8 Turns, #16 AWG

L21, L22 : 12 Turns, #22 AWG

## BIAS VOLTAGE SOURCE



C15 : 10nF + 100nF + 10 $\mu$ F

C16 : 10nF

C17 : 1 $\mu$ F

C18 : 1.2nF + 27nF + 10 $\mu$ F

D1 : AAY 49 Ge Diode Thermally Connected with Q3 heatsink

D2 : 1N 400S - Si Diode Thermally Connected with Q3 heatsink

D3 : 1n 400S - Si Diode Thermally Connected with SD1492 (RF Transistors) Flange

L6, L9 : Ferrite Choice

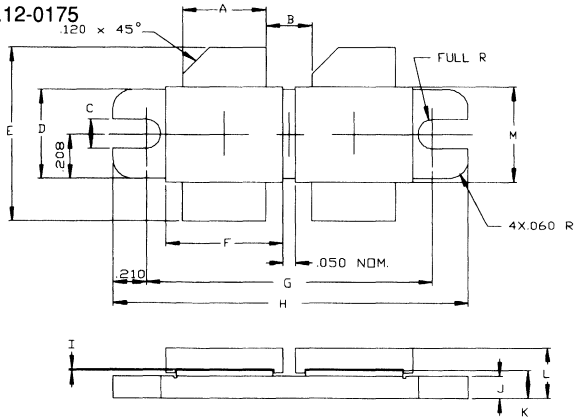
Q : Box 63B

R6 : 100 $\Omega$  Trimpot

R7 : 470 $\Omega$ , 1/2W

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0175



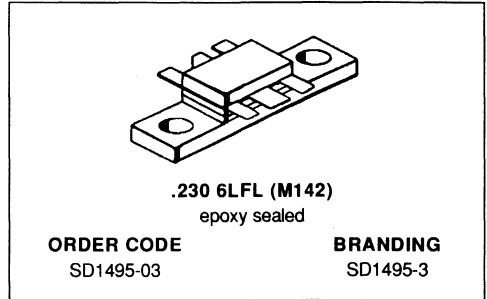
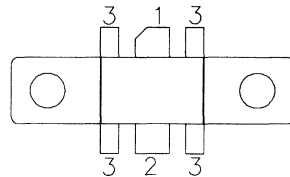
SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.373/9,47	.385/9,78	K	.115/2,92	.135/3,43
B	.190/4,83		L	.250/6,35	
C	.125/3,18		M	.445/11,30	.455/11,56
D	.411/10,44	.421/10,69			
E	.825/20,96	865/21,97			
F	.525/13,34	535/13,59			
G	1.255/31,88	1.265/32,13			
H	1.675/42,55	1.685/42,80			
I	.002/0,05	.006/0,15			
J	.095/2,41	.105/2,67			





**RF & MICROWAVE TRANSISTORS  
800/900 MHz APPLICATIONS**

- 960 MHz
- 24 VOLTS
- EFFICIENCY 50%
- COMMON BASE
- $P_{OUT} = 30 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$


**PIN CONNECTION**


- |              |         |
|--------------|---------|
| 1. Collector | 3. Base |
| 2. Emitter   |         |

**DESCRIPTION**

The SD1495-03 is a 24 V Class C epitaxial silicon NPN planar transistor designed primarily for amplifier applications in the 900 - 960 MHz frequency range. Internal input matching and common base configuration assure optimum gain and efficiency across the entire frequency band.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	50	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{CES}$	Collector-Emitter Voltage	50	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	9.0	A
$P_{DISS}$	Power Dissipation	100	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

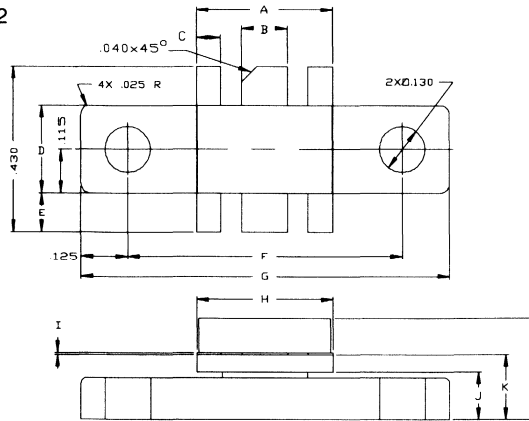
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{\text{CES}}$	$I_{\text{C}} = 50\text{mA}$	$V_{\text{BE}} = 0\text{V}$		50	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$		30	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$		4.0	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 15\text{V}$	$I_{\text{E}} = 0\text{mA}$		—	—	5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 1\text{A}$		10	—	120	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 6.0\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	30	—	—	W
$G_{\text{P}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 6.0\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	7.0	—	—	dB
$\eta_{\text{C}}$	$f = 960\text{ MHz}$	$P_{\text{IN}} = 6.0\text{ W}$	$V_{\text{CE}} = 24\text{ V}$	50	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 24\text{ V}$		—	—	55	pF

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0142

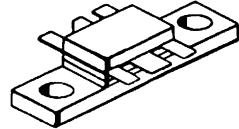


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.355/9,02	.365/9,27	K	.160/4,06	.180/4,57
B	.115/2,92	.125/3,18	L	.230/5,84	.260/6,60
C	.075/1,91	.085/2,16			
D	.225/5,72	.235/5,97			
E	.090/2,29	.110/2,79			
F	.720/18,29	.730/18,54			
G	.970/24,64	.980/24,89			
H	.355/9,02	.365/9,27			
I	.004/0,10	.006/0,15			
J	.120/3,05	.130/3,30			



**RF & MICROWAVE TRANSISTORS**  
**800/900 MHz APPLICATIONS**

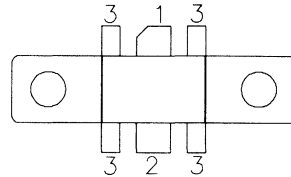
- 900 MHz
- 24 VOLTS
- EFFICIENCY 50%
- COMMON BASE
- $P_{OUT} = 60$  W MIN. WITH 7.5 dB GAIN



**.230 6LFL (M142)**  
epoxy sealed

**ORDER CODE**  
SD1496

**BRANDING**  
SD1496

**PIN CONNECTION**


1. Collector                      3. Base  
2. Emitter

**DESCRIPTION**

The SD1496 is a 24 V Class C epitaxial silicon NPN transistor designed for base station applications in the 860 - 900 MHz frequency range.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	50	V
$V_{CEO}$	Collector-Emitter Voltage	26	V
$V_{CES}$	Collector-Emitter Voltage	50	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	9	A
$P_{DISS}$	Power Dissipation	190	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.9	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{E}} = 0\text{mA}$	50	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 50\text{mA}$	$V_{\text{BE}} = 0\text{V}$	50	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$	26	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.0	—	—	V
$I_{\text{CES}}$	$V_{\text{CE}} = 20\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	10	mA
$I_{\text{CBO}}$	$V_{\text{CB}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 1\text{A}$	20	—	100	—

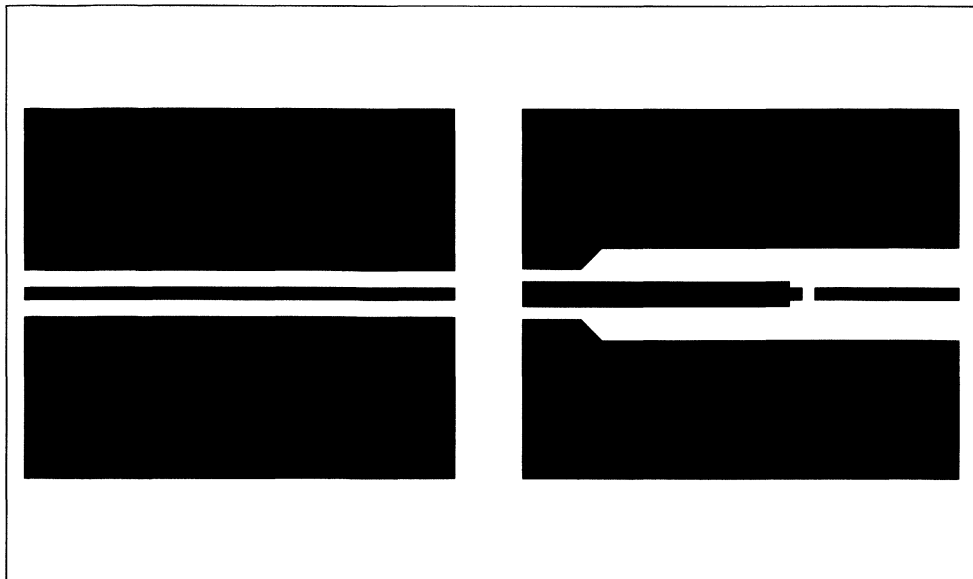
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 860 \text{ — } 900 \text{ MHz}$	$P_{\text{IN}} = 10.6 \text{ W}$	$V_{\text{CE}} = 24 \text{ V}$	60	—	—	W
$G_{\text{P}}$	$f = 860 \text{ — } 900 \text{ MHz}$	$P_{\text{IN}} = 10.6 \text{ W}$	$V_{\text{CE}} = 24 \text{ V}$	7.5	—	—	dB
$\eta_{\text{C}}$	$f = 860 \text{ — } 900 \text{ MHz}$	$P_{\text{IN}} = 10.6 \text{ W}$	$V_{\text{CE}} = 24 \text{ V}$	—	50	—	%
$C_{\text{OB}}$	$f = 1 \text{ MHz}$	$V_{\text{CB}} = 24 \text{ V}$		—	55	—	pF

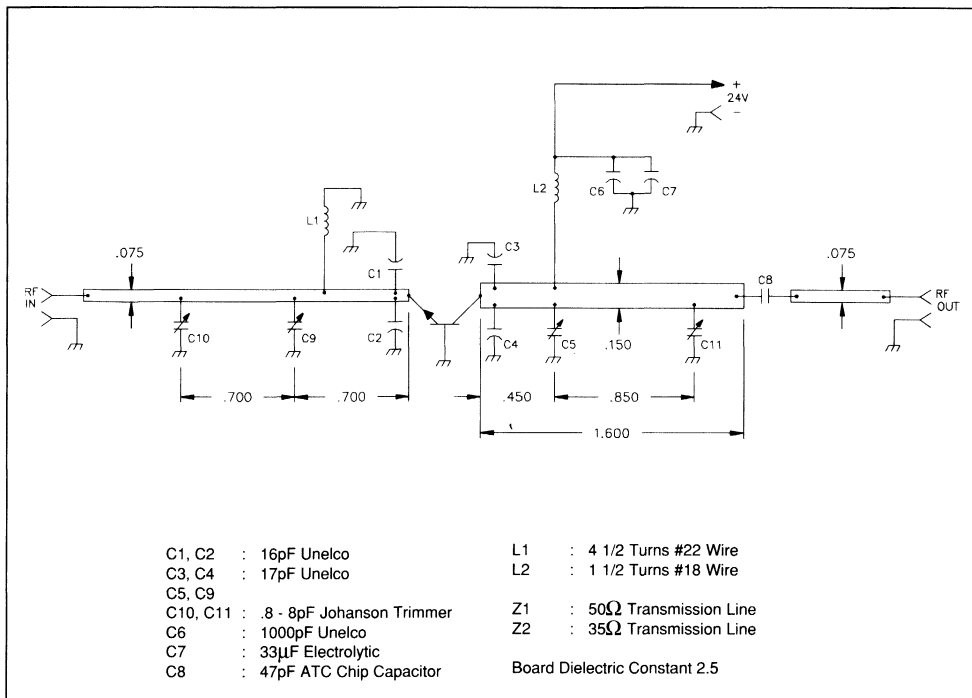
## IMPEDANCE DATA

FREQ.	$Z_{\text{IN}} (\Omega)$	$Z_{\text{CL}} (\Omega)$
900 MHz	$1.0 + j 4.9$	$1.40 + j 1.3$
890 MHz	$1.2 + j 5.1$	$1.35 + j 1.2$
880 MHz	$1.45 + j 5.2$	$1.25 + j 1.1$
860 MHz	$2.0 + j 5.4$	$1.15 + j 0.85$

## TEST CIRCUIT LAYOUT



## TEST CIRCUIT

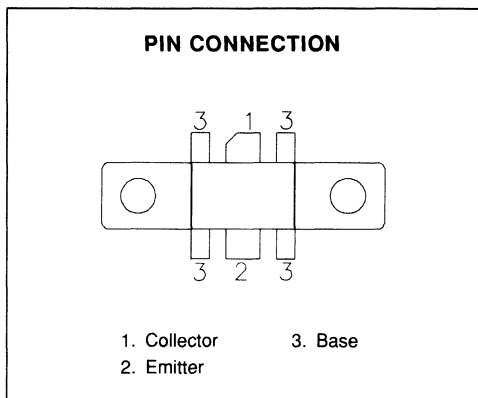
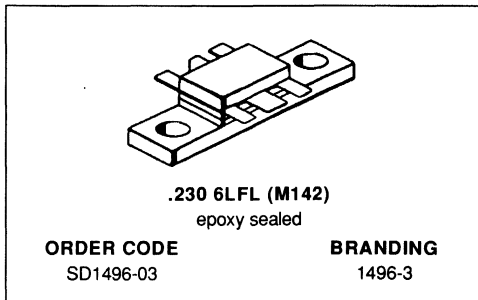






**RF & MICROWAVE TRANSISTORS**  
**800/900 MHz APPLICATIONS**

- 960 MHz
- 24 VOLTS
- EFFICIENCY 50%
- COMMON BASE CONFIGURATION
- INTERNAL INPUT MATCHING
- $P_{OUT} = 55 \text{ W MIN. WITH } 7.4 \text{ dB GAIN}$


**DESCRIPTION**

The SD1496-03 is a 24 V Class C epitaxial silicon NPN planar transistor designed primarily for amplifier applications in the 900 - 960 MHz frequency range. Internal input matching and common base configuration assure optimum gain and efficiency across the entire frequency band.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	50	V
V <sub>CEO</sub>	Collector-Emitter Voltage	26	V
V <sub>CES</sub>	Collector-Emitter Voltage	50	V
V <sub>EBO</sub>	Emitter-Base Voltage	4.0	V
I <sub>C</sub>	Device Current	9	A
P <sub>DISS</sub>	Power Dissipation	190	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	0.9	°C/W
----------------------	----------------------------------	-----	------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

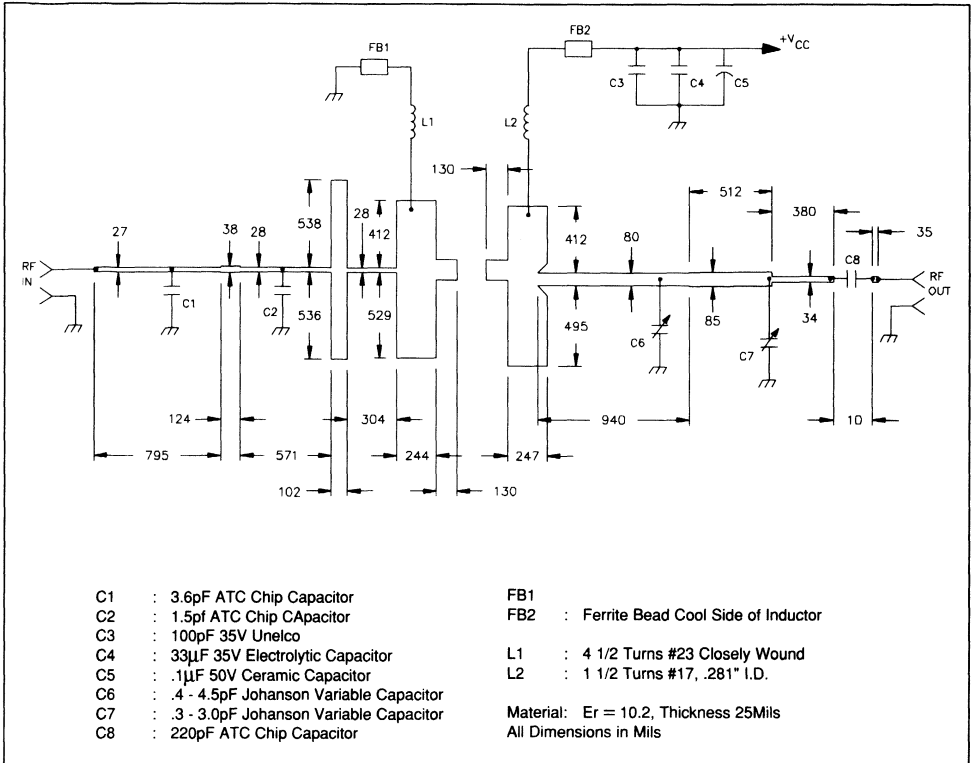
## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50mA$	$I_E = 0mA$	50	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	50	—	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	26	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.0	—	—	V
$I_{CES}$	$V_{CE} = 20V$	$I_E = 0mA$	—	—	10	mA
$I_{CBO}$	$V_{CB} = 30V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	20	—	100	—

## DYNAMIC

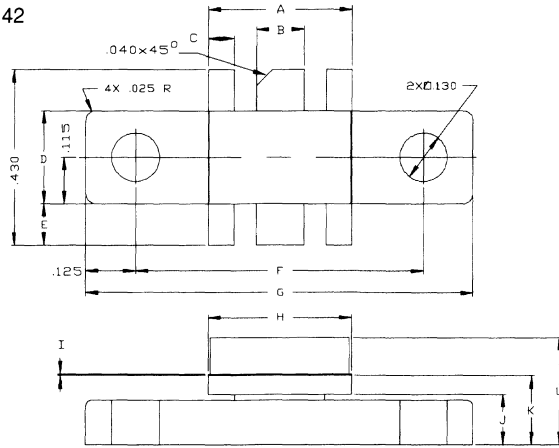
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 960 MHz$	$P_{IN} = 10.0 W$	$V_{CE} = 24 V$	55	—	—	W
$G_P$	$f = 960 MHz$	$P_{IN} = 10.0 W$	$V_{CE} = 24 V$	7.4	—	—	dB
$\eta_C$	$f = 960 MHz$	$P_{IN} = 10.0 W$	$V_{CE} = 24 V$	—	50	—	%
$COB$	$f = 1 MHz$	$V_{CB} = 24 V$		—	55	—	pF

## TEST CIRCUIT



PACKAGE MECHANICAL DATA

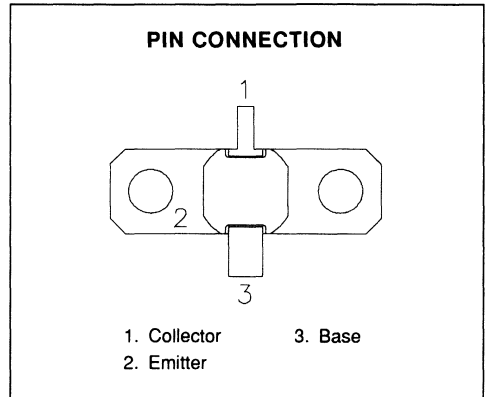
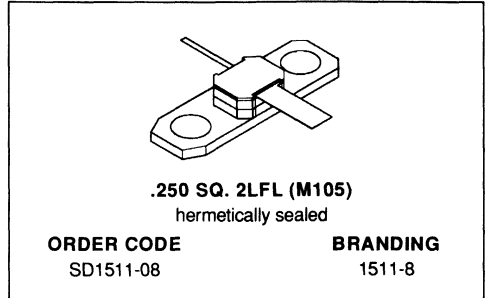
Ref.: Dwg. No.12-0142



SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.355/9,02	.365/9,27	K	.160/4,06	.180/4,57
B	.115/2,92	.125/3,18	L	.230/5,84	.260/6,60
C	.075/1,91	.085/2,16			
D	.225/5,72	.235/5,97			
E	.090/2,29	.110/2,79			
F	.720/18,29	.730/18,54			
G	.970/24,64	.980/24,89			
H	.355/9,02	.365/9,27			
I	.004/0,10	.006/0,15			
J	.120/3,05	.130/3,30			

**RF & MICROWAVE TRANSISTORS  
 UHF RADAR APPLICATIONS**

- 425 MHz
- 28 VOLTS
- COMMON EMITTER
- EMITTER BALLASTED
- GOLD METALLIZATION
- $P_{OUT} = 10$  W MIN. WITH 9.2 dB GAIN


**DESCRIPTION**

The SD1511-08 is a gold metallized silicon NPN power transistor designed for CW and pulsed radar applications in the 400 - 450 MHz frequency range.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	58.3	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.0	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

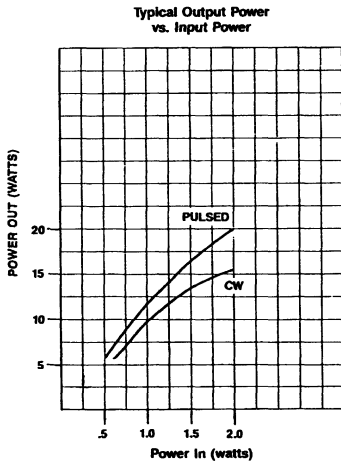
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 30V$	$I_E = 0mA$	—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	10	—	100	—

**DYNAMIC**

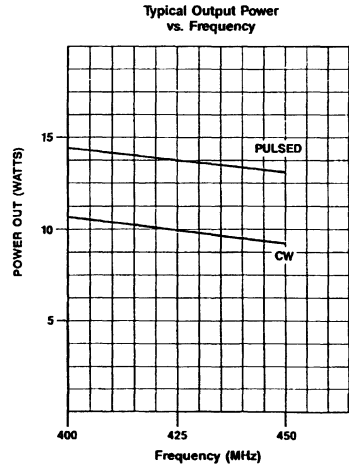
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 425\text{ MHz}$	$P_{IN} = 1.2\text{ W}$	$V_{CE} = 28\text{ V}$	10	—	—	W
$G_P$	$f = 425\text{ MHz}$	$P_{IN} = 1.2\text{ W}$	$V_{CE} = 28\text{ V}$	9.2	—	—	dB
$\eta_C$	$f = 425\text{ MHz}$	$P_{IN} = 1.2\text{ W}$	$V_{CE} = 28\text{ V}$	50	—	—	%

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

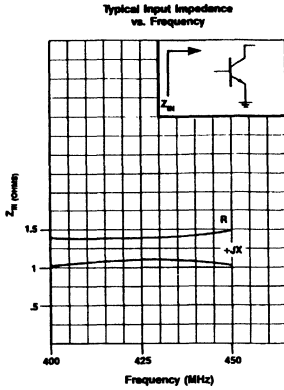


**POWER OUTPUT vs FREQUENCY**

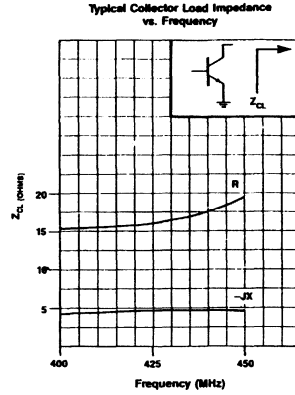


## IMPEDANCE DATA

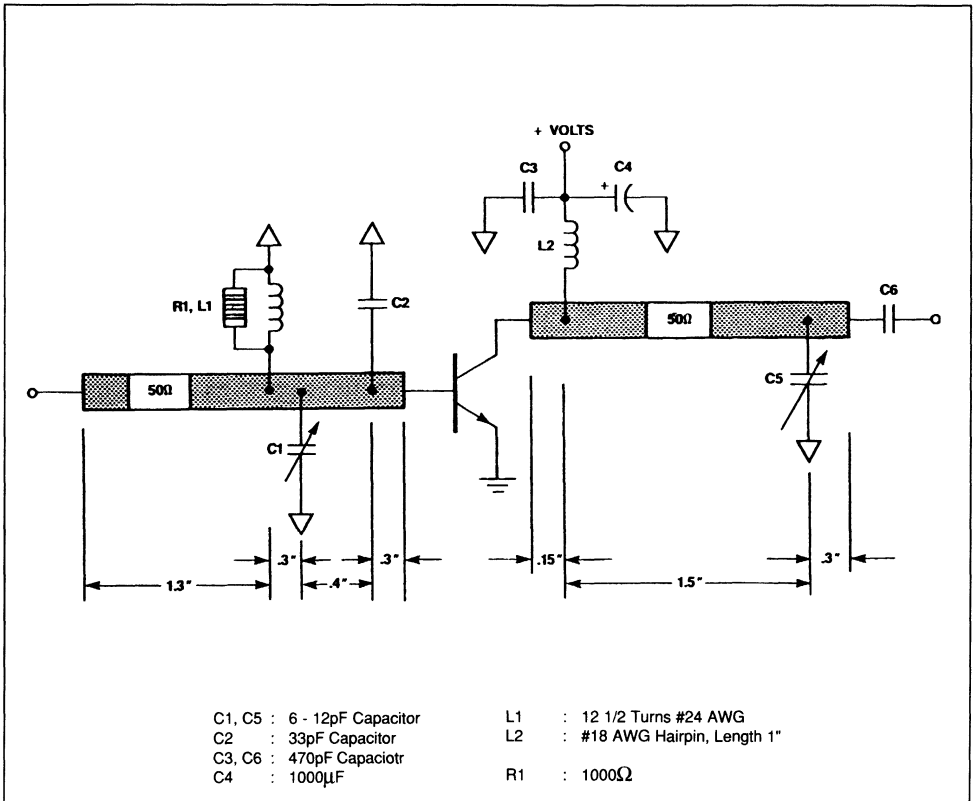
## TYPICAL INPUT IMPEDANCE



## TYPICAL COLLECTOR LOAD IMPEDANCE

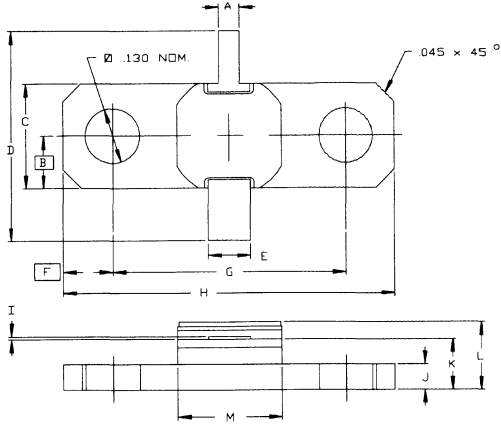


## TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0105

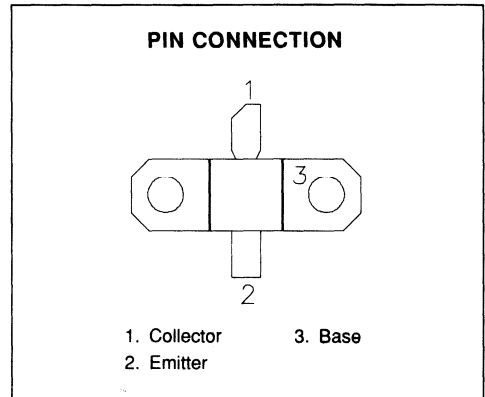
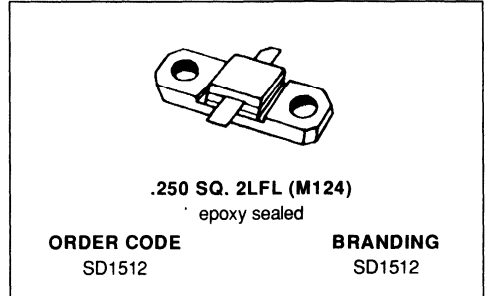


SGS-THOMSON MICROELECTRONIC		CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.112/2,84
B	.125/3,18		L	.175/4,45
C	.245/6,22	.255/6,48	M	.245/6,22
D	1.235/31,37			
E	.095/2,41	.105/2,67		
F	.120/3,05			
G	.557/14,15	.567/14,40		
H	.795/20,19	.805/20,45		
I	.002/0,05	.006/0,15		
J	.057/1,45	.067/1,70		



## RF & MICROWAVE TRANSISTORS SPECIAL AVIONICS APPLICATIONS

- 960 - 1220 MHz
- 30 VOLTS
- EXTREMELY RUGGED
- THERMALLY STABLE
- GOLD METALLIZATION
- DESIGNED FOR LONG PULSE L-BAND APPLICATIONS
- $P_{OUT} = 5.0$  W MIN. WITH 7.0 dB GAIN



### DESCRIPTION

The SD1512 is a gold metallized epitaxial silicon NPN planar pulsed transistor that has been designed for use in extended pulse width and duty cycle applications from 960 - 1220 MHz.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	53	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.3	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{CEO}$	$I_C = 10mA$	$I_B = 0mA$	30	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CBO}$	$V_{CB} = 28V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	20	—	—	—

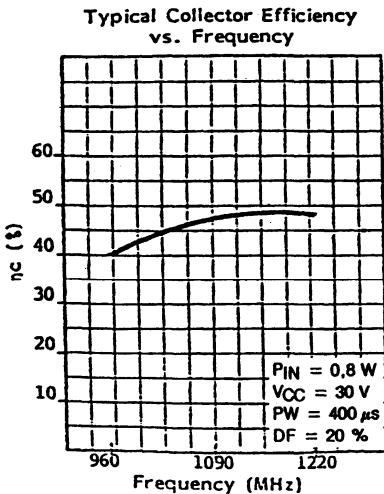
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 960 - 1220$ MHz	$P_{IN} = 1.0$ W	$V_{CE} = 30$ V	5	—	—	W
$G_P$	$f = 960 - 1220$ MHz	$P_{IN} = 1.0$ W	$V_{CE} = 30$ V	7	—	—	dB

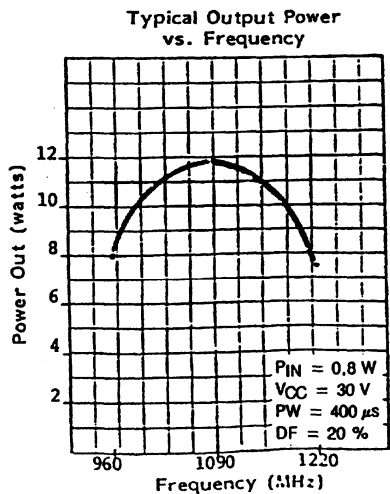
Note: Pulse Width = 400 $\mu$ Sec  
Duty Cycle = 20%

TYPICAL PERFORMANCE

COLLECTOR EFFICIENCY vs FREQUENCY



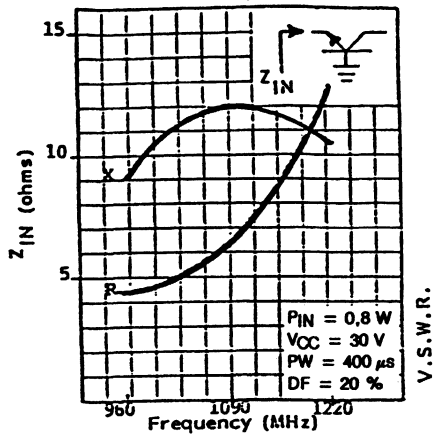
POWER OUTPUT vs FREQUENCY



## IMPEDANCE DATA

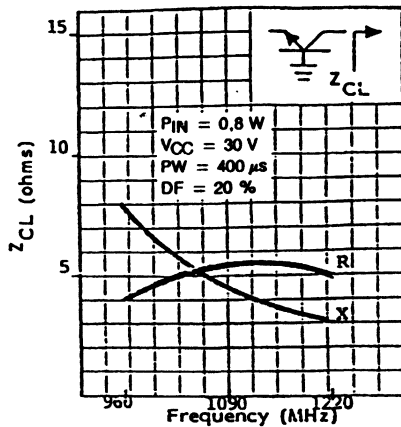
## TYPICAL INPUT IMPEDANCE

Typical Input Impedance vs. Frequency

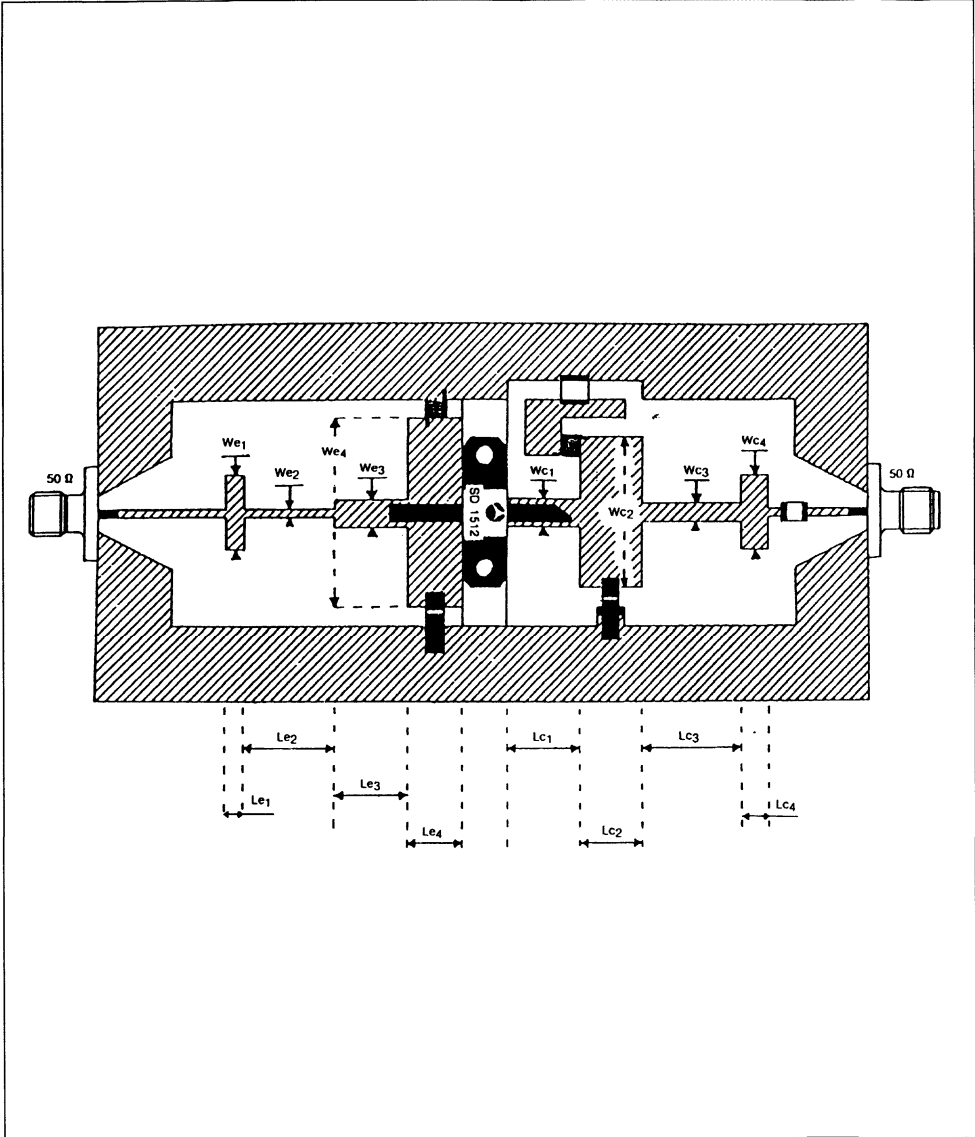


## TYPICAL COLLECTOR LOAD IMPEDANCE

Typical Collector Load Impedance vs. Frequency

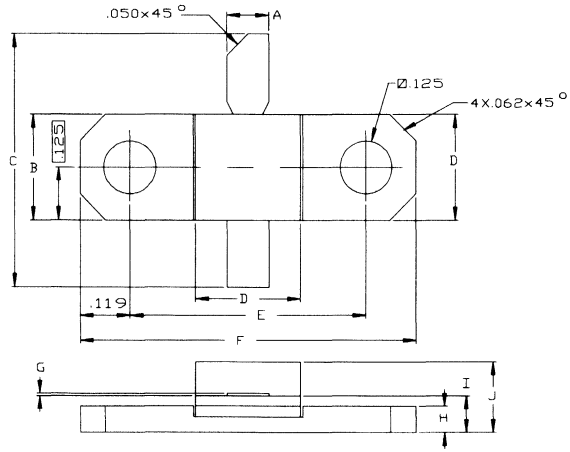


TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0124

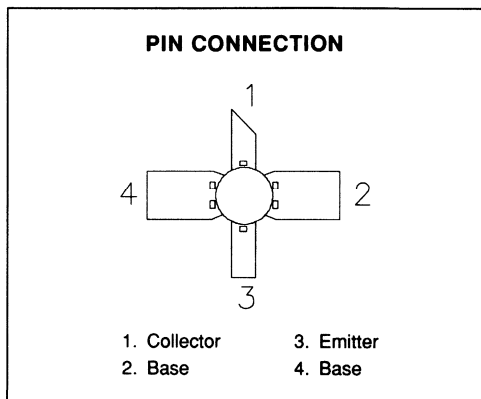
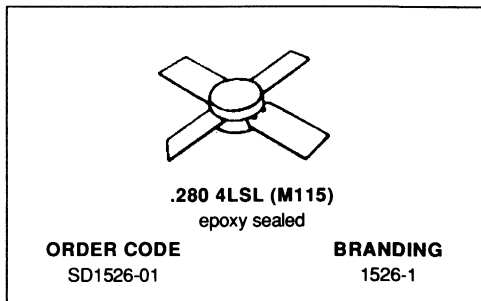


SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	.105/2,67
B	.245/6,22	.255/6,48
C	.750/19,05	
D	.245/6,22	.258/6,55
E	.555/14,10	.570/14,48
F	.795/20,19	.805/20,45
G	.003/0,08	.007/0,18
H	.055/1,40	.065/1,65
I	.075/1,91	.100/2,54
J	.150/3,81	.180/4,57



## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 6.0 WATTS (typ.) IFF 1030 - 1090 MHz
- 5.0 WATTS (min.) DME 1025 - 1150 MHz
- 4.0 WATTS (typ.) TACAN 960 - 1215 MHz
- 9.5 dB MIN. GAIN
- LOW THERMAL RESISTANCE
- EMITTER BALLASTED
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION



### DESCRIPTION

The SD1526-01 is a gold metallized, silicon NPN power transistor. The SD1526-01 is designed for pulsed applications with low duty cycles such as IFF, DME, TACAN. The SD1526-01 is packaged in the .280" input matched stripline package resulting in improved broadband performance and a low thermal resistance.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	45	V
V <sub>CES</sub>	Collector-Emitter Voltage	45	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>c</sub>	Device Current	1.0	A
P <sub>DISS</sub>	Power Dissipation	21.9	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	8.0	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{CES}$	$I_C = 1mA$	$V_{BE} = 0V$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 28V$	$I_E = 0mA$	—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	200	—

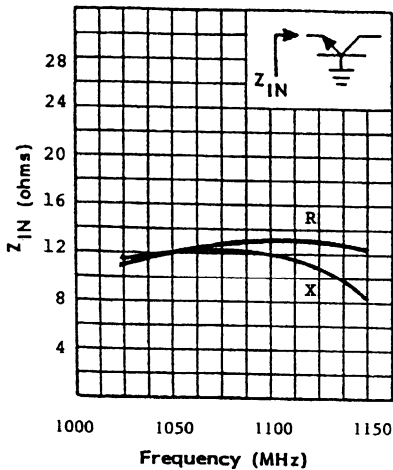
DYNAMIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = .55 W$ $V_{CE} = 28 V$	5	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = .55 W$ $V_{CE} = 28 V$	9.5	—	—	dB

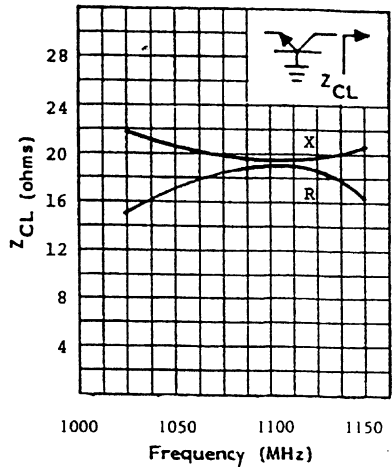
Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%  
 This device is suitable for use under other pulse widths/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

**IMPEDANCE DATA**

TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



$P_{IN} = 0.5 w$   
 $V_{CE} = 28 V$   
 Pulse Width  $10\mu sec$   
 Duty Cycle 1%

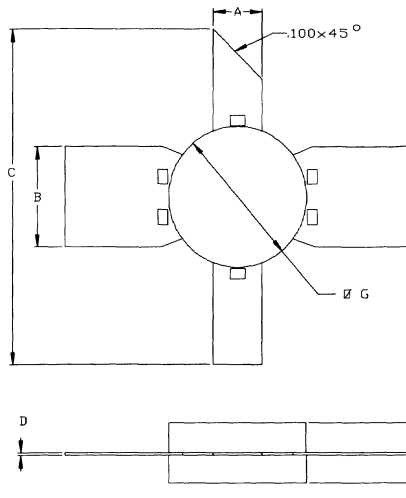




PACKAGE MECHANICAL DATA

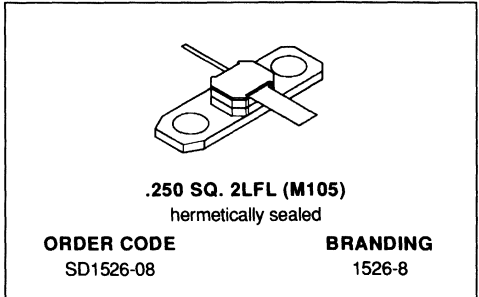
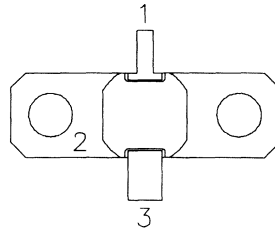
Ref.: Dwg. No.12-0115

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	.105/2,67
B	.195/4,95	.205/5,21
C	1.000/25,40	
D	.004/0,10	.007/0,18
E	.050/1,27	.065/1,65
F	.120/3,05	.135/3,43
G	.275/6,99	.285/7,21



**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 6.0 WATTS (typ.) IFF 1030 - 1090 MHz
- 5.0 WATTS (min.) DME 1025 - 1150 MHz
- 4.0 WATTS (typ.) TACAN 960 - 1215 MHz
- 9.5 dB MIN. GAIN
- LOW THERMAL RESISTANCE
- EMITTER BALLASTED
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      |            |

**DESCRIPTION**

The SD1526-08 is a gold metallized, silicon NPN power transistor. The SD1526-08 is designed for pulsed applications with low duty cycles such as IFF, DME, TACAN. The SD1526-08 is packaged in the .250" input matched stripline package resulting in improved broadband performance and a low thermal resistance.

**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	45	V
V <sub>CES</sub>	Collector-Emitter Voltage	45	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>c</sub>	Device Current	1.0	A
P <sub>DISS</sub>	Power Dissipation	21.9	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	8.0	°C/W
----------------------	----------------------------------	-----	------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	45	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0V$	45	—	—	V
$BV_{CES}$	$I_C = 5mA$	$V_{BE} = 0V$	45	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 28V$	$I_E = 0mA$	—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	10	—	200	—

## DYNAMIC

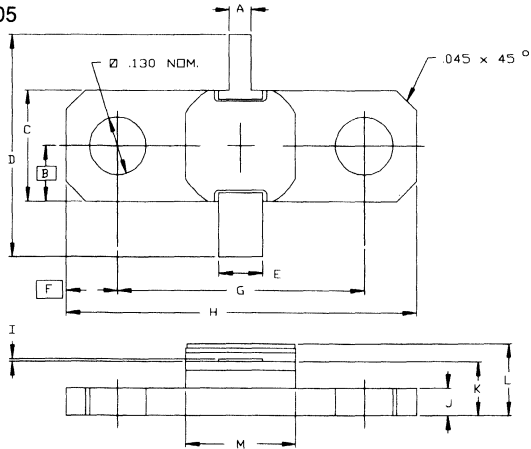
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = .55 W$	$V_{CE} = 28 V$	5	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = .55 W$	$V_{CE} = 28 V$	9.5	—	—	dB

Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%

This device is suitable for use under other pulse widths/duty cycle conditions.  
Please contact the factory for specific applications assistance.

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0105

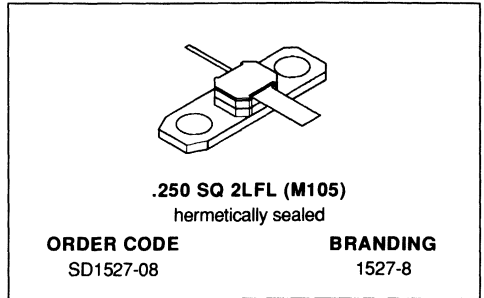


SGS-THOMSON MICROELECTRONIC		COND			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.112/2,84	.132/3,35
B	.125/3,18		L	.175/4,45	
C	.245/6,22	.255/6,48	M	.245/6,22	.257/6,53
D	1.235/31,37				
E	.095/2,41	.105/2,67			
F	.120/3,05				
G	.557/14,15	.567/14,40			
H	.795/20,19	.805/20,45			
I	.002/0,05	.006/0,15			
J	.057/1,45	.067/1,70			



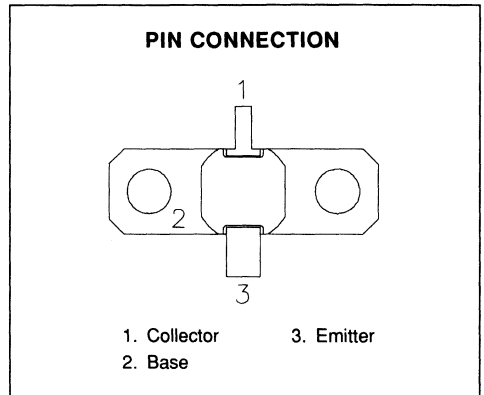
## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- 5.0 WATTS (min.) IFF 1030 - 1090 MHz
- 4.0 WATTS (typ.) TACAN 960 - 1215 MHz
- DESIGNED FOR HIGH POWER PULSED IFF AND TACAN APPLICATIONS
- LOW THERMAL RESISTANCE
- INPUT MATCHED, COMMON BASE CONFIGURATION
- INFINITE LOAD VSWR CAPABILITY @ SPECIFIED OPERATING CONDITIONS



### DESCRIPTION

The SD1527-08 is a gold metallized, epitaxial silicon NPN power transistor. The SD1527-08 is designed for pulsed applications with low duty cycles such as IFF, DME, TACAN. The SD1527-08 is packaged in the .250" input matched hermetic stripline flange package resulting in improved broadband performance and a low thermal resistance.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	80	V
V <sub>CES</sub>	Collector-Emitter Voltage	80	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>c</sub>	Device Current	1.0	A
P <sub>DISS</sub>	Power Dissipation	21.9	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	8.0	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 10mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	1	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	15	—	200	—

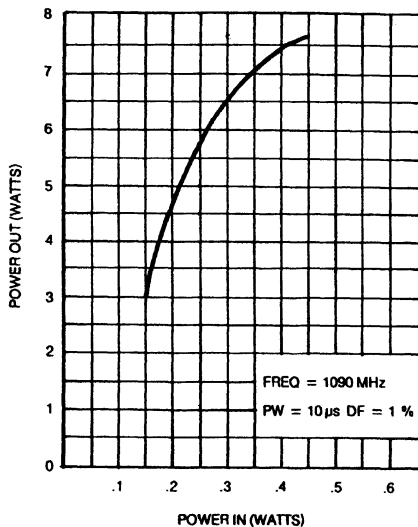
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090\text{ MHz}$	$P_{IN} = 0.35\text{ W}$	$V_{CE} = 50\text{ V}$	5.0	—	—	W
$G_P$	$f = 1090\text{ MHz}$	$P_{IN} = 0.35\text{ W}$	$V_{CE} = 50\text{ V}$	11.5	—	—	dB

Note: Pulse Width =  $10\mu\text{Sec}$   
 Duty Cycle = 1%

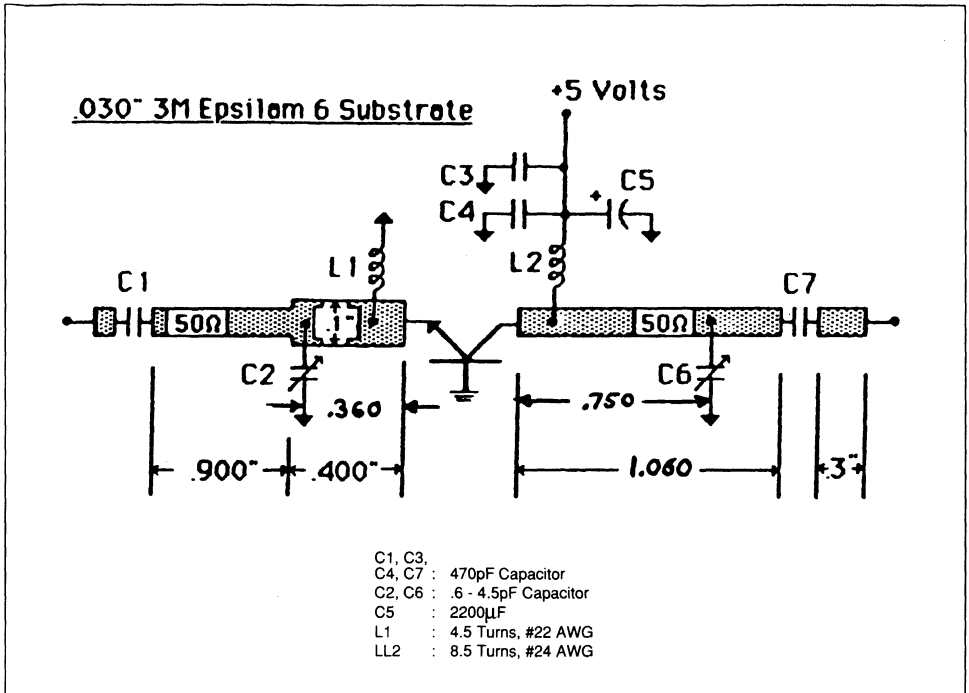
**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**



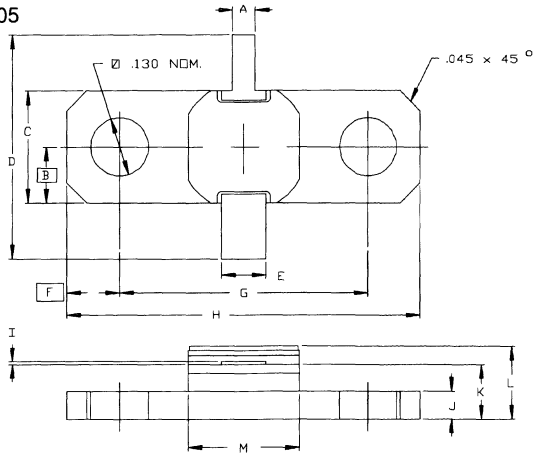


## TEST CIRCUIT



PACKAGE MECHANICAL DATA

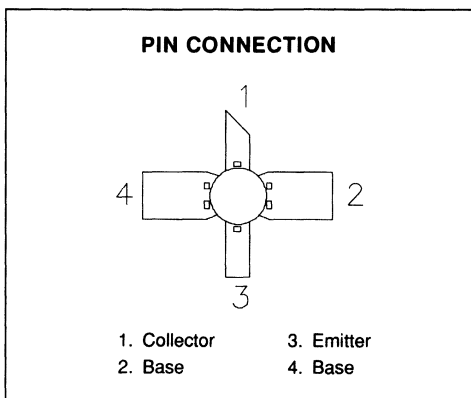
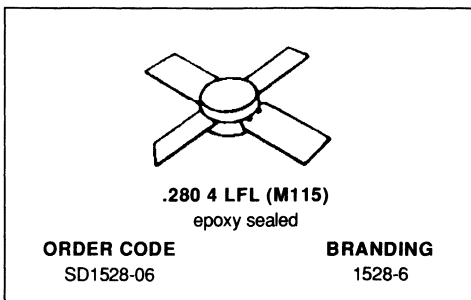
Ref.: Dwg. No.12-0105



SGS-THOMSON MICROELECTRONIC			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.112/2,84
B	.125/3,18		L	.175/4,45
C	.245/6,22	.255/6,48	M	.245/6,22
D	1.235/31,37			
E	.095/2,41	.105/2,67		
F	.120/3,05			
G	.557/14,15	.567/14,40		
H	.795/20,19			
I	.002/0,05	.006/0,15		
J	.057/1,45	.067/1,70		

**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 20 W (typ.) IFF 1030 - 1090 MHz
- 15 W (min.) DME 1025 - 1150 MHz
- 15 W (typ.) TACAN 960 - 1215 MHz
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTED AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 20:1 LOAD VSWR CAPABILITY @ SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1528-06 is a gold metallized epitaxial silicon NPN power transistor. The SD1528-06 is designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1528-06 is packaged in the .280" input matched stripline package, resulting in improved broadband performance and low thermal resistance.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	1.5	A
$P_{DISS}$	Power Dissipation	87.5	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.0	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	2	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = .1A$	10	—	200	—

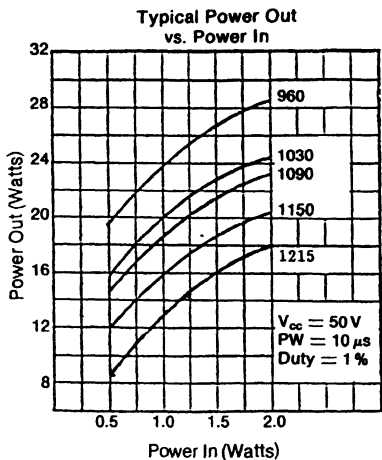
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 1.5 W$	$V_{CE} = 50 V$	15	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 1.5 W$	$V_{CE} = 50 V$	10	—	—	dB
$\eta_C$	$f = 1025 - 1150MHz$	$P_{IN} = 1.5 W$	$V_{CE} = 50 V$	30	—	—	%

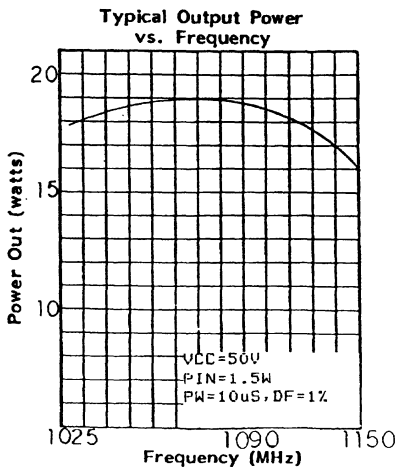
Note: Pulse Width = 10μsec, Duty Cycle = 1%

**TYPICAL PERFORMANCE**

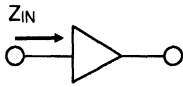
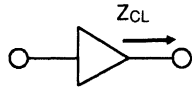
**POWER OUTPUT vs POWER INPUT**



**POWER OUTPUT vs FREQUENCY**



## IMPEDANCE DATA

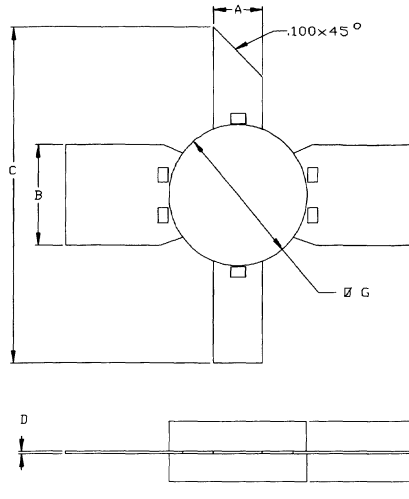
TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
960 MHz	$2.5 + j 12.5$	$17.0 + j 15.5$
1030 MHz	$3.5 + j 12.5$	$17.0 + j 14.5$
1090 MHz	$3.0 + j 13.5$	$19.5 + j 12.5$
1150 MHz	$3.5 + j 14.0$	$18.0 + j 12.0$
1215 MHz	$5.0 + j 17.0$	$16.0 + j 12.0$

PACKAGE MECHANICAL DATA

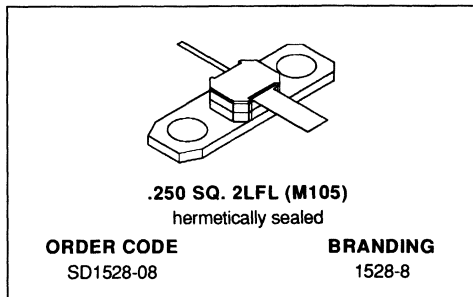
Ref.: Dwg. No.12-0115

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	.105/2,67
B	.195/4,95	.205/5,21
C	1.000/25,40	
D	.004/0,10	.007/0,18
E	.050/1,27	.065/1,65
F	.120/3,05	.135/3,43
G	.275/6,99	.285/7,21



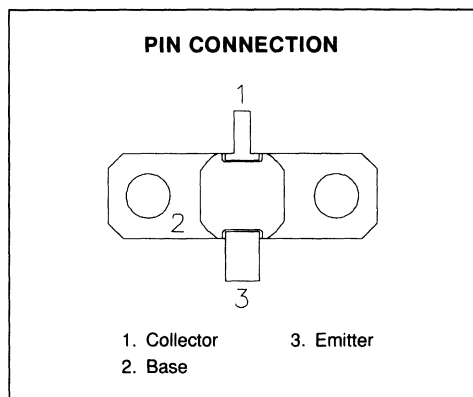
## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 20 WATTS (typ.) IFF 1030 - 1090 MHz
- 15 WATTS (min.) DME 1025 - 1150 MHz
- 15 WATTS (typ.) TACAN 960 - 1215 MHz
- 10 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE
- 20:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION



### DESCRIPTION

The SD1528-08 is a gold metallized, silicon NPN power transistor. The SD1528-08 is designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1528-08 is packaged in the .250" input matched hermetic stripline flange package resulting in improved broadband performance and a low thermal resistance.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	65	V
V <sub>CE0</sub>	Collector-Emitter Voltage	65	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>C</sub>	Device Current	1.5	A
P <sub>DISS</sub>	Power Dissipation	87.5	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	2.0	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	2	mA

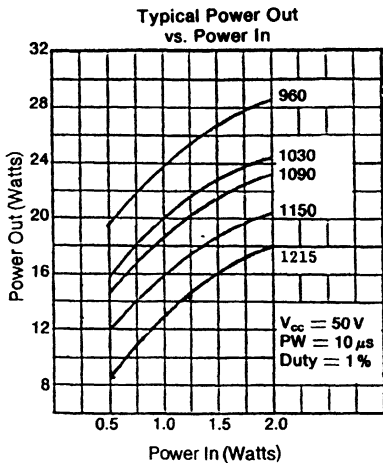
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 1.5 W$	$V_{CE} = 50 V$	15	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 1.5 W$	$V_{CE} = 50 V$	10	—	—	dB
$\eta_C$	$f = 1025 - 1150MHz$	$P_{IN} = 1.5 W$	$V_{CE} = 50 V$	30	—	—	%

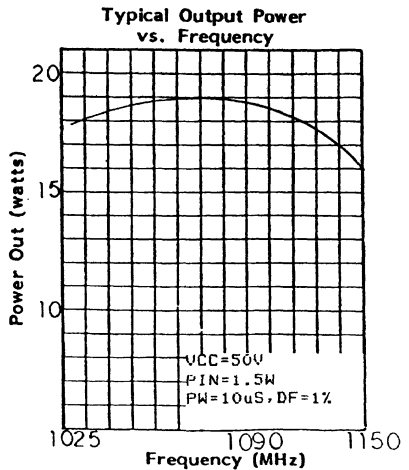
Note: Pulse Width = 10µSec, Duty Cycle = 1%

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**



**POWER OUTPUT vs FREQUENCY**

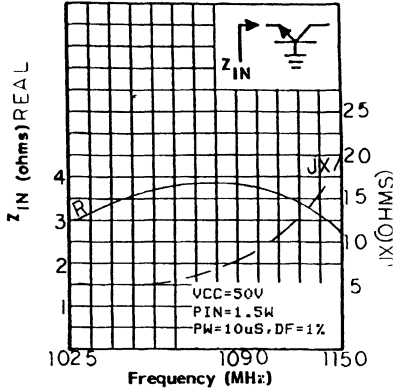




## IMPEDANCE DATA

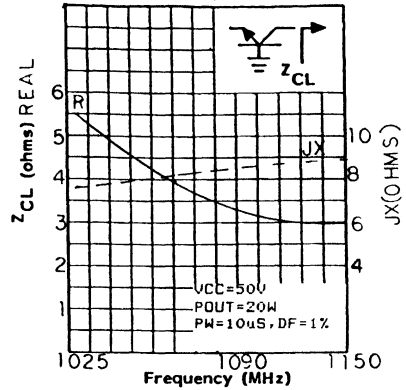
## TYPICAL INPUT IMPEDANCE

Typical Input Impedance vs. Frequency

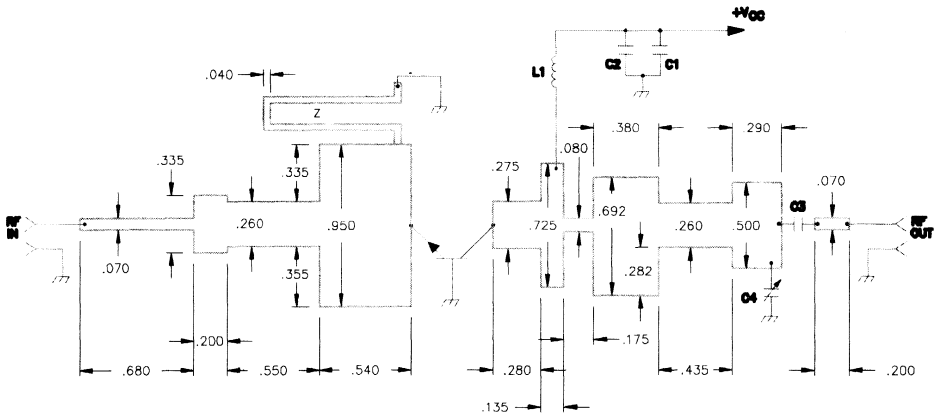


## TYPICAL COLLECTOR LOAD IMPEDANCE

Typical Collector Load Impedance vs. Frequency



## TEST CIRCUIT



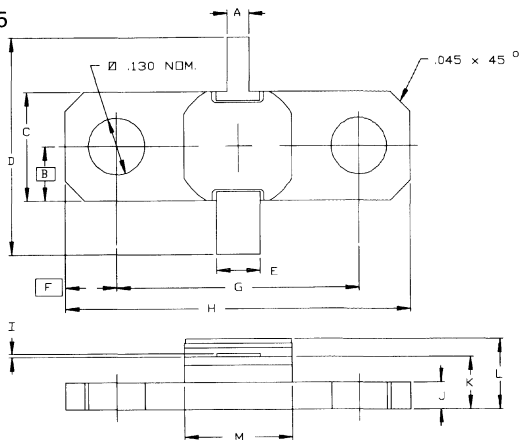
- C1 : 1000 $\mu$ F Electrolytic  
 C2 : 680pF Chip Capacitor  
 C3 : 120pF Chip Capacitor  
 C4 : 0.6 - 4.5pF Johanson Gigatrim

- L1 : 6 1/2 Turns, #22 AWG on a #30 Drill Bit  
 Z : Printed Transmission Line, Length = 1.91"

Board :  $\epsilon_r = 2.5$ , .034" Thick  
 All Dimensions are in Inches.

PACKAGE MECHANICAL DATA

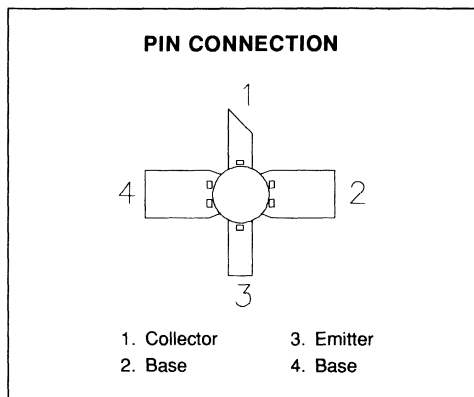
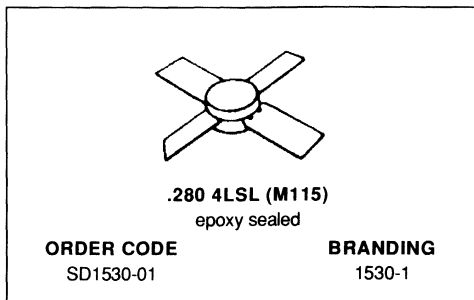
Ref.: Dwg. No.12-0105



SGS-THOMSON MICROELECTRONIC			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.112/2,84	.132/3,35
B	.125/3,18		L	.175/4,45	
C	.245/6,22	.255/6,48	M	.245/6,22	.257/6,53
D	1.235/31,37				
E	.095/2,41	.105/2,67			
F	.120/3,05				
G	.557/14,15	.567/14,40			
H	.795/20,19	.805/20,45			
I	.002/0,05	.006/0,15			
J	.057/1,45	.067/1,70			

**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 40 WATTS (typ.) IFF 1030 - 1090 MHz
- 35 WATTS (min.) DME 1025 - 1150 MHz
- 25 WATTS (typ.) TACAN 960 - 1215 MHz
- 9.0 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1530-01 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1530-01 is packaged in the .280" input matched stripline package resulting in improved broadband performance and a low thermal resistance.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	65	V
V <sub>CES</sub>	Collector-Emitter Voltage	65	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>c</sub>	Device Current	2.6	A
P <sub>DISS</sub>	Power Dissipation	87.5	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	2.0	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

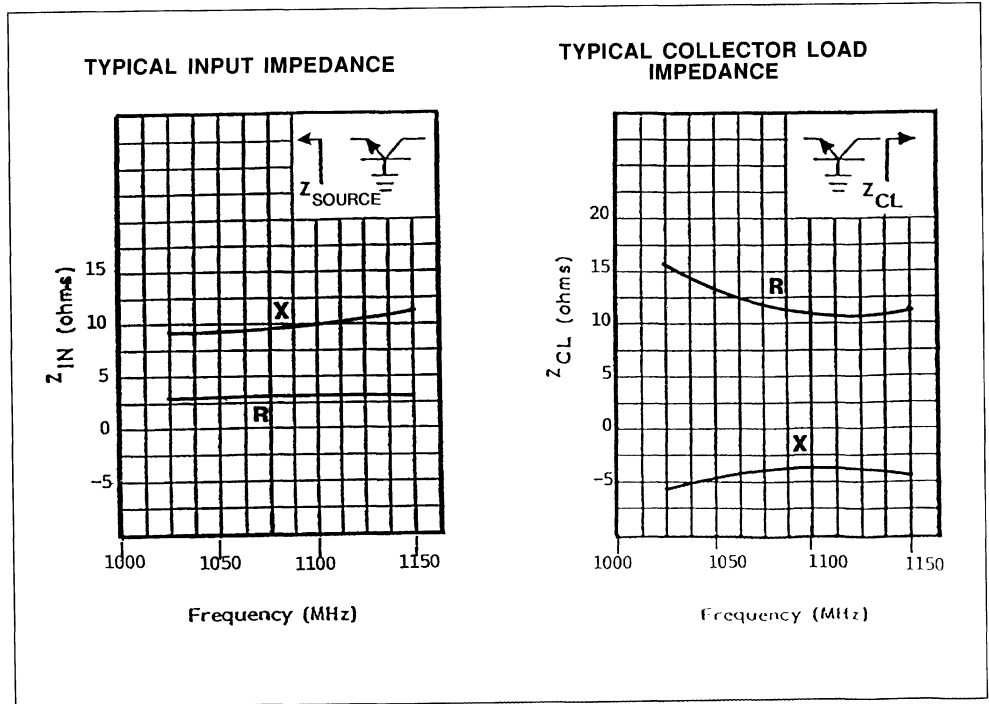
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 20mA$	$I_E = 0mA$	60	—	—	V
$BV_{CES}$	$I_C = 20mA$	$V_{BE} = 0V$	60	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{CB} = 50V$	$I_E = 0mA$	—	—	2	mA

**DYNAMIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 5.6 W, V_{CE} = 50 V$	35	—	—	W
GP	$f = 1025 - 1150MHz$	$P_{IN} = 5.6 W, V_{CE} = 50 V$	9.0	—	—	dB

Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

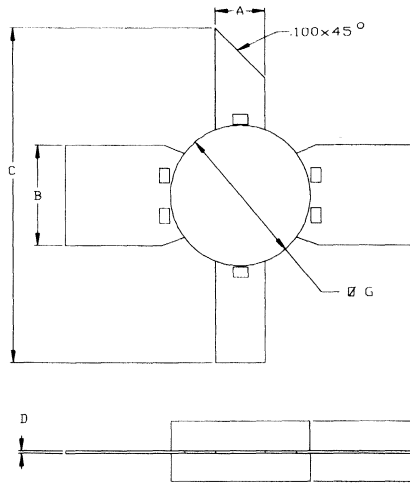
**IMPEDANCE DATA**



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0115

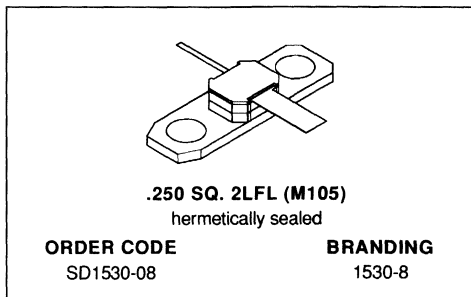
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	.105/2,67
B	.195/4,95	.205/5,21
C	1.000/25,40	
D	.004/0,10	.007/0,18
E	.050/1,27	.065/1,65
F	.120/3,05	.135/3,43
G	.275/6,99	.285/7,21



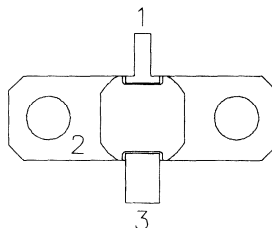


## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 40 WATTS (typ.) IFF 1030 - 1090 MHz
- 35 WATTS (min.) DME 1025 - 1150 MHz
- 25 WATTS (typ.) TACAN 960 - 1215 MHz
- 9.0 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION



### PIN CONNECTION



- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      |            |

### DESCRIPTION

The SD1530-08 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1530-08 is packaged in the .250" input matched hermetic stripline flange package resulting in improved broadband performance and a low thermal resistance.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	65	V
V <sub>CEO</sub>	Collector-Emitter Voltage	65	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>c</sub>	Device Current	2.6	A
P <sub>DISS</sub>	Power Dissipation	87.5	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	2.0	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	5	mA

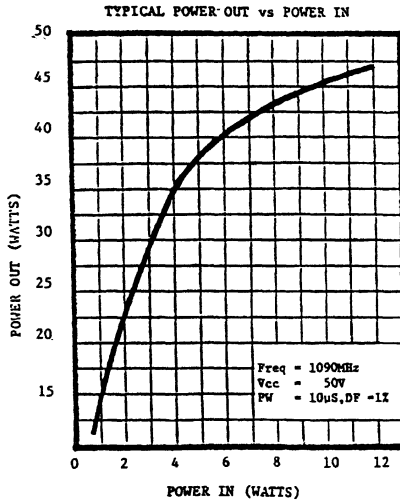
**DYNAMIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 5.0 W$ $V_{CE} = 50 V$	35	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 5.0 W$ $V_{CE} = 50 V$	9.0	—	—	dB
$\eta_C$	$f = 1025 - 1150MHz$	$P_{IN} = 5.0 W$ $V_{CE} = 50 V$	30	—	—	%

Note: Pulse Width = 10 $\mu$ Sec, Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

**TYPICAL PERFORMANCE**

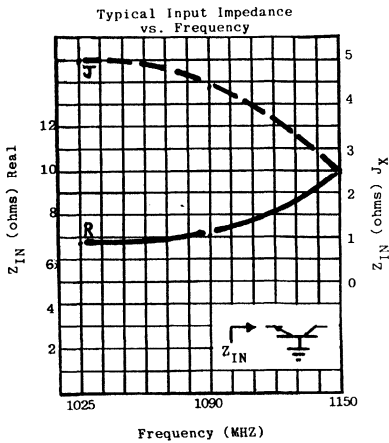
**POWER OUTPUT vs POWER INPUT**



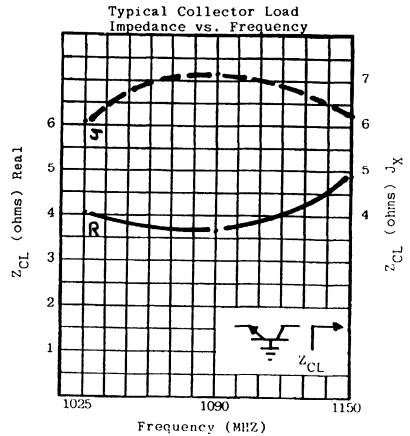


IMPEDANCE DATA

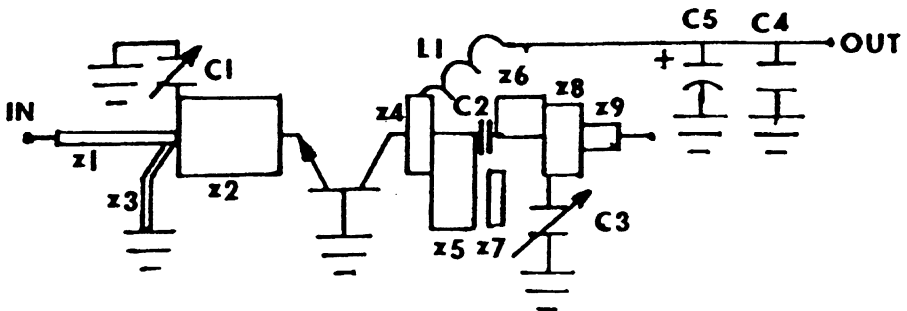
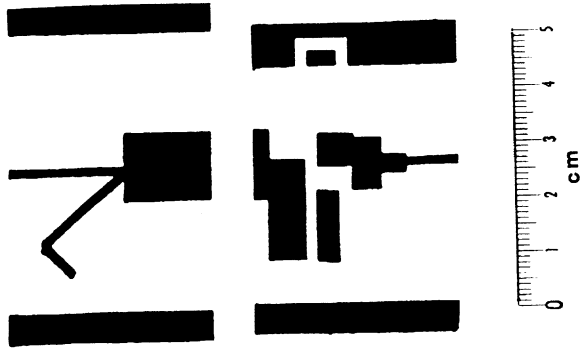
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



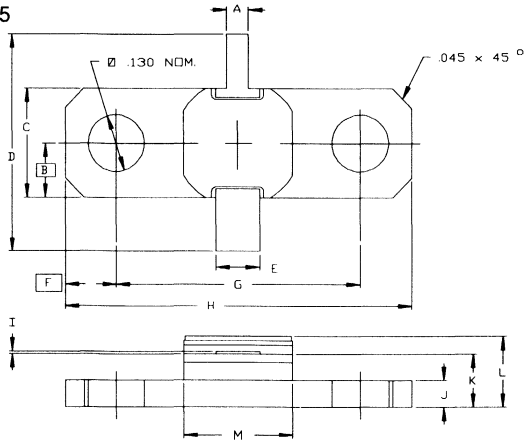
## TEST CIRCUIT AND PC BOARD LAYOUT



C1, C3	: 0.6 - 4.5pF, Johanson Gigatrim	Z4	: .110" x .490"
C2	: 470pF ATC Chip Capacitor	Z5	: .250" x .700"
C4	: 1000pF ATC Chip Capacitor	Z6	: .250" x .225"
C5	: 1000 $\mu$ F, 63V, Electrolytic Capacitor	Z7	: Ground
L1	: 4.5 Turns #22 AWG Wire	Z8	: .185" x .360"
Z1	: 500mm Line	Z9	: .180" x .120"
Z2	: .450" Wire Line Length .600"		
Z3	: 50 $\Omega$ Shunt Line		

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0105

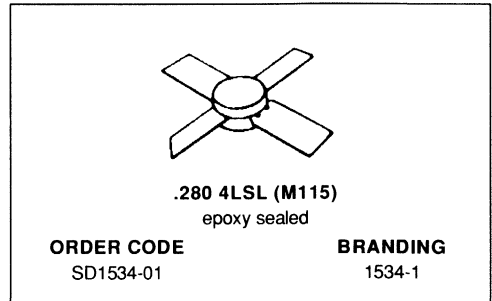


SGS-THOMSON MICROELECTRONIC		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.112/2,84	.132/3,35
B	.125/3,18		L	.175/4,45	
C	.245/6,22	.255/6,48	M	.245/6,22	.257/6,53
D	1.235/31,37				
E	.095/2,41	.105/2,67			
F	.120/3,05				
G	.557/14,15	.567/14,40			
H	.795/20,19	.805/20,45			
I	.002/0,05	.006/0,15			
J	.057/1,45	.067/1,70			

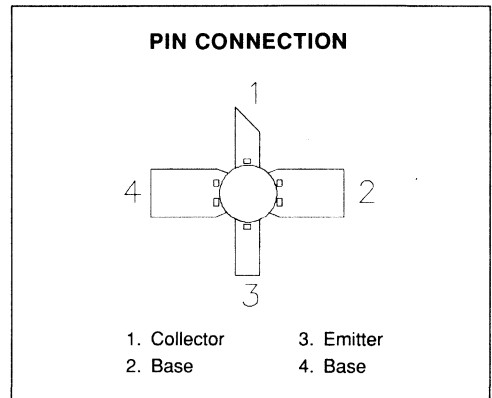


**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 80 WATTS (typ.) IFF 1030 - 1090 MHz
- 75 WATTS (min.) DME 1025 - 1150 MHz
- 50 WATTS (typ.) TACAN 960 - 1215 MHz
- 8.0 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1534-01 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1534-01 is packaged in the .280" input matched stripline package resulting in improved broadband performance and a low thermal resistance.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	65	V
V <sub>CES</sub>	Collector-Emitter Voltage	65	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>c</sub>	Device Current	5.5	A
P <sub>DISS</sub>	Power Dissipation	218.7	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	0.8	°C/W
----------------------	----------------------------------	-----	------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	10	—	—	—

## DYNAMIC

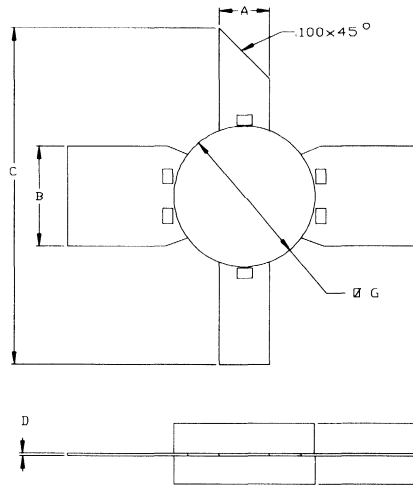
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 \text{ — } 1150MHz$	$P_{IN} = 13.0W$	$V_{CE} = 50 V$	75	—	—	W
$G_P$	$f = 1025 \text{ — } 1150MHz$	$P_{IN} = 13.0W$	$V_{CE} = 50 V$	7.6	—	—	dB

Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0115

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	.105/2,67
B	.195/4,95	.205/5,21
C	1.000/25,40	
D	.004/0,10	.007/0,18
E	.050/1,27	.065/1,65
F	.120/3,05	.135/3,43
G	.275/6,99	.285/7,21





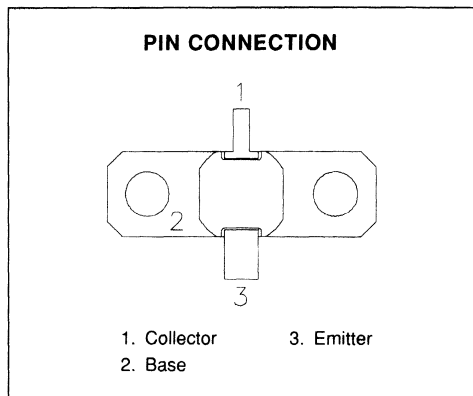
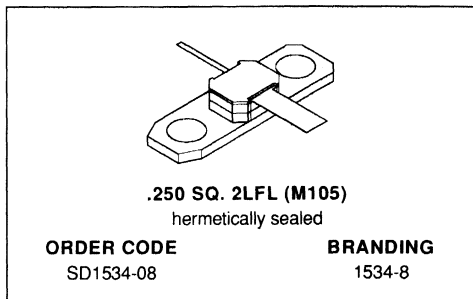


**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 80 WATTS (typ.) IFF 1030 - 1090 MHz
- 75 WATTS (min.) DME 1025 - 1150 MHz
- 50 WATTS (typ.) TACAN 960 - 1215 MHz
- 8.0 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION

**DESCRIPTION**

The SD1534-08 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1534-08 is packaged in the .280" input matched hermetic stripline flange package resulting in improved broadband performance and a low thermal resistance.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	5.5	A
$P_{DISS}$	Power Dissipation	218.7	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.8	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	10	—	200	—

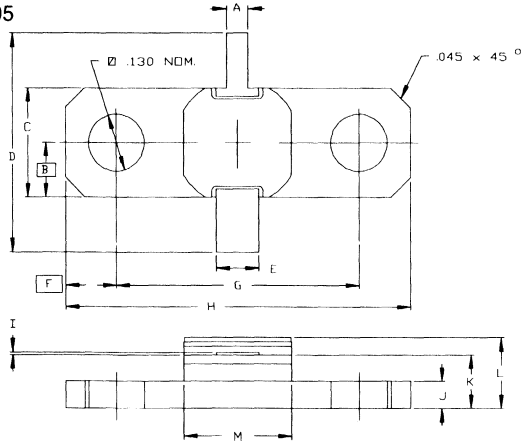
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 13.5 W$	$V_{CE} = 50 V$	75	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 13.5 W$	$V_{CE} = 50 V$	7.5	—	—	dB

Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0105

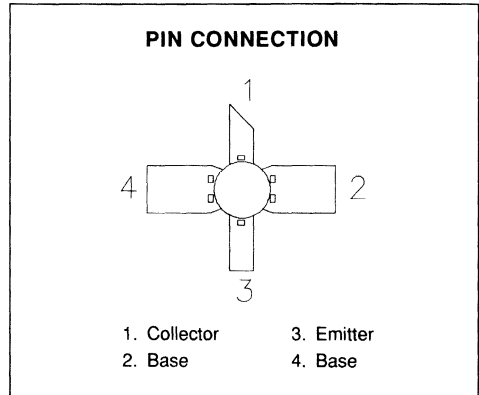
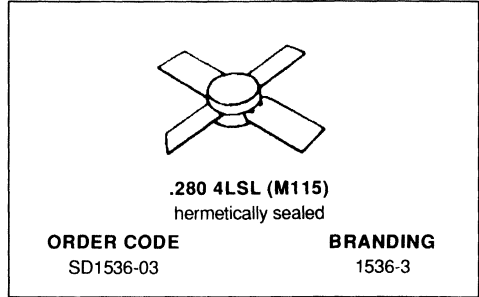


SGS-THOMSON MICROELECTRONIC			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.112/2,84	.132/3,35
B	.125/3,18		L	.175/4,45	
C	.245/6,22	.255/6,48	M	.245/6,22	.257/6,53
D	1.235/31,37				
E	.095/2,41	.105/2,67			
F	.120/3,05				
G	.557/14,15	.567/14,40			
H	.795/20,19	.805/20,45			
I	.002/0,05	.006/0,15			
J	.057/1,45	.067/1,70			



**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 100 WATTS (typ.) IFF 1030 - 1090 MHz
- 90 WATTS (min.) DME 1025 - 1150 MHz
- 90 WATTS (typ.) TACAN 960 - 1215 MHz
- 8.4 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1536-03 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1536-03 is packaged in the .280" input matched stripline package resulting in improved broadband performance and a low thermal resistance.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_c$	Device Current	10	A
$P_{DISS}$	Power Dissipation	292	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.60	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CER}$	$I_C = 25mA$	$R_{BE} = 10\Omega$	65	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 100mA$	5	—	—	—

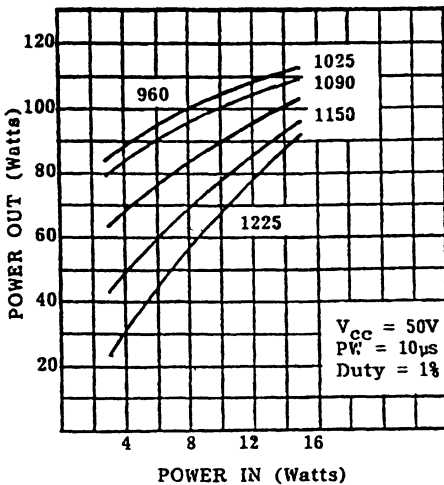
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 \text{ — } 1150MHz$	$P_{IN} = 13.0 W$	$V_{CE} = 50 V$	90	—	—	W
$G_P$	$f = 1025 \text{ — } 1150MHz$	$P_{IN} = 13.0 W$	$V_{CE} = 50 V$	8.4	—	—	dB

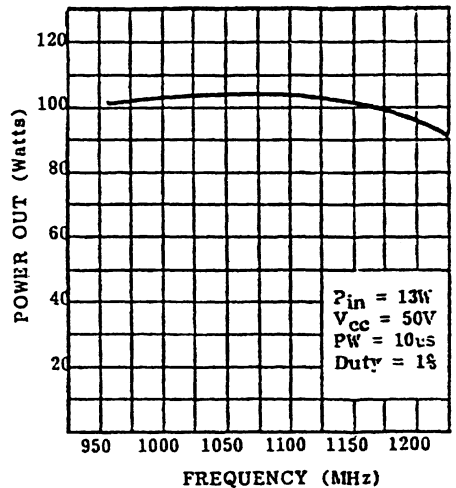
Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions  
 Please contact the factory for specific applications assistance.

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**



**POWER OUTPUT vs FREQUENCY**



## IMPEDANCE DATA

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
960 MHz	2.5 + j 13.0	4.6 - j 5.5
1030 MHz	5.2 + j 15.0	5.0 - j 5.5
1090 MHz	16.3 + j 15.0	4.8 - j 5.5
1150 MHz	14.7 + j 2.5	4.7 - j 7.0
1215 MHz	7.6 + j 0.5	4.7 - j 5.0

P<sub>IN</sub> = 13 W

V<sub>CE</sub> = 50 V

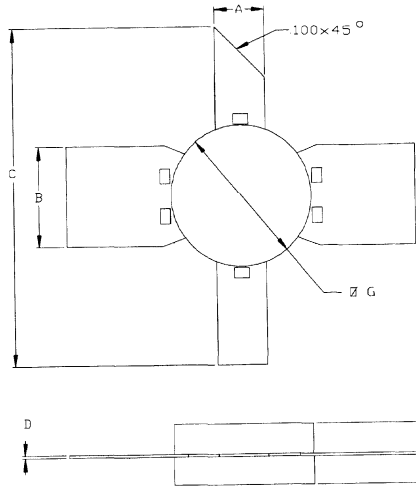
Pulse Width = 10μSec

Duty Cycle = 1%

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0115

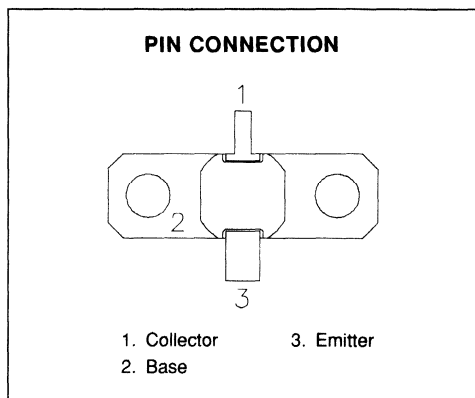
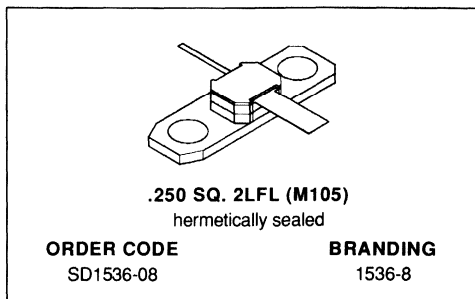
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	105/2,67
B	.195/4,95	205/5,21
C	1.000/25,40	
D	.004/0,10	.007/0,18
E	.050/1,27	.065/1,65
F	.120/3,05	.135/3,43
G	.275/6,99	.285/7,21





**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 100 WATTS (typ.) IFF 1030 - 1090 MHz
- 90 WATTS (min.) DME 1025 - 1150 MHz
- 90 WATTS (typ.) TACAN 960 - 1215 MHz
- 8.4 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1536-08 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1536-08 is packaged in the .250" input matched hermetic stripline flange package resulting in improved broadband performance and a low thermal resistance.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_c$	Device Current	10	A
$P_{DISS}$	Power Dissipation	292	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.60	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 10mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>CER</sub>	I <sub>C</sub> = 25mA	R <sub>BE</sub> = 10Ω	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 50V	I <sub>E</sub> = 0mA	—	—	10	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 100mA	5	—	—	—

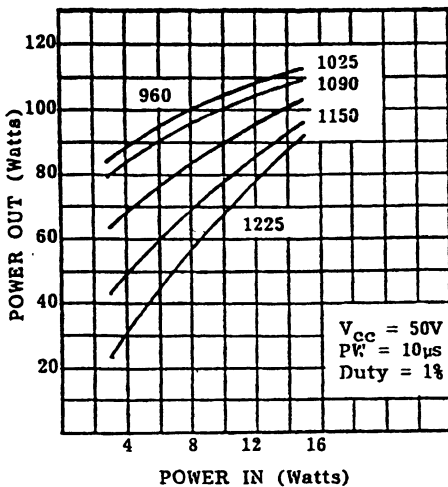
DYNAMIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 1025 — 1150MHz	P <sub>IN</sub> = 13.0 W V <sub>CE</sub> = 50 V	90	—	—	W
G <sub>p</sub>	f = 1025 — 1150MHz	P <sub>IN</sub> = 13.0 W V <sub>CE</sub> = 50 V	8.4	—	—	dB

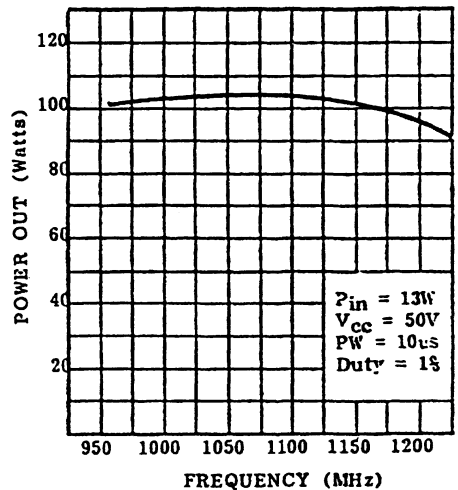
Note: Pulse Width = 10μSec, Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions  
 Please contact the factory for specific applications assistance.

TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

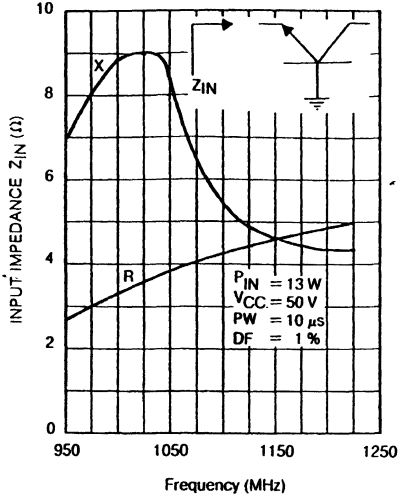


POWER OUTPUT vs FREQUENCY

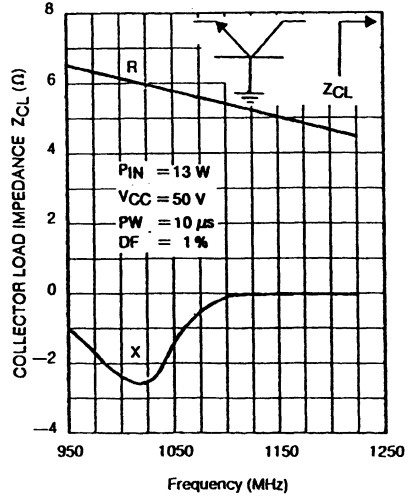


## IMPEDANCE DATA

## TYPICAL INPUT IMPEDANCE

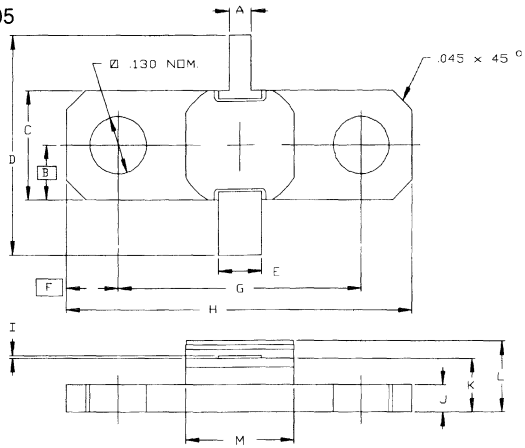
TYPICAL INPUT IMPEDANCE  
VERSUS FREQUENCY

## TYPICAL COLLECTOR LOAD IMPEDANCE

TYPICAL COLLECTOR LOAD IMPEDANCE  
VERSUS FREQUENCY

PACKAGE MECHANICAL DATA

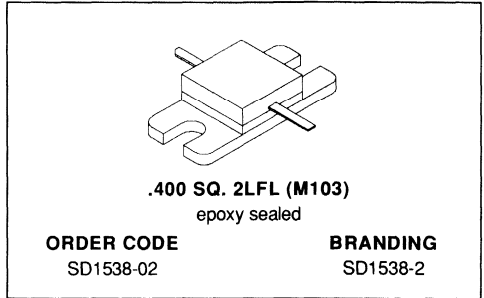
Ref.: Dwg. No.12-0105



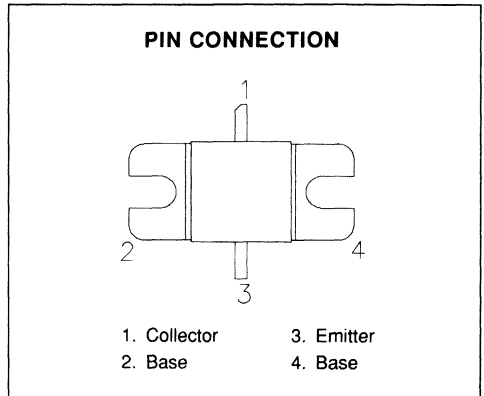
SGS-THOMSON MICROELECTRONIC			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.112/2,84	.132/3,35
B	.125/3,18		L		.175/4,45
C	.245/6,22	.255/6,48	M	.245/6,22	.257/6,53
D	1.235/31,37				
E	.095/2,41	.105/2,67			
F	.120/3,05				
G	.557/14,15	.567/14,40			
H	.795/20,19	.805/20,45			
I	.002/0,05	.006/0,15			
J	.057/1,45	.067/1,70			

**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 200 WATTS (typ.) IFF 1030 - 1090 MHz
- 150 WATTS (min.) DME 1025 - 1150 MHz
- 140 WATTS (typ.) TACAN 960 - 1215 MHz
- 7.8 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT/OUTPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1538-02 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1538-02 is packaged in a metal/ceramic package with internal input/output matching resulting in improved broadband performance and a low thermal resistance.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	11.0	A
$P_{DISS}$	Power Dissipation	583	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.30	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 300mA$	5	—	—	—

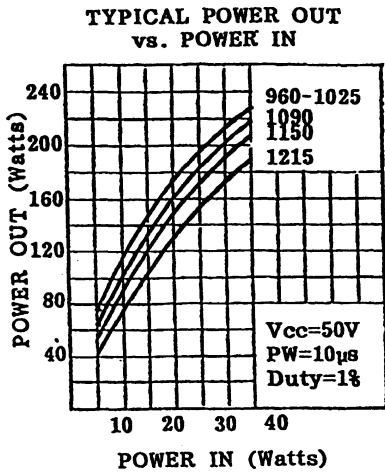
DYNAMIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 25.0 W, V_{CE} = 50V$	50	50	—	W
GP	$f = 1025 - 1150MHz$	$P_{IN} = 25.0 W, V_{CE} = 50V$	50	50	—	dB

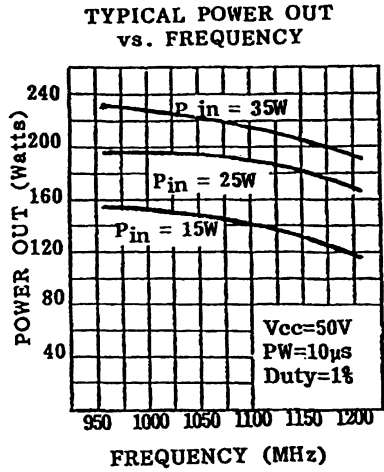
Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

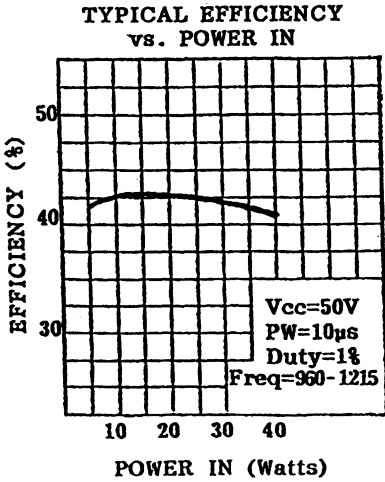


POWER OUTPUT vs FREQUENCY

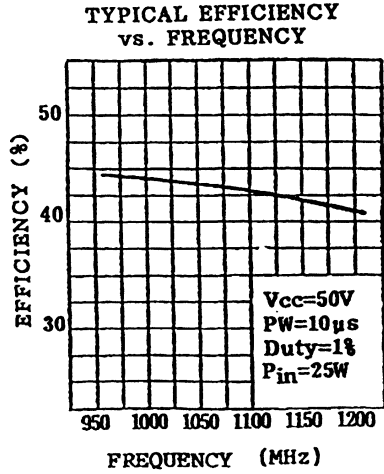


TYPICAL PERFORMANCE (cont'd)

EFFICIENCY vs POWER INPUT

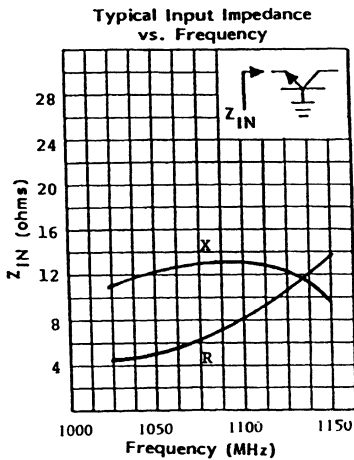


EFFICIENCY vs FREQUENCY

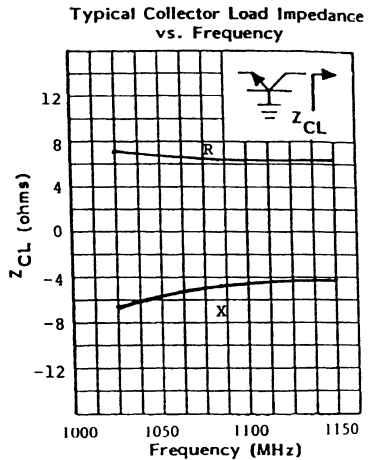


IMPEDANCE DATA

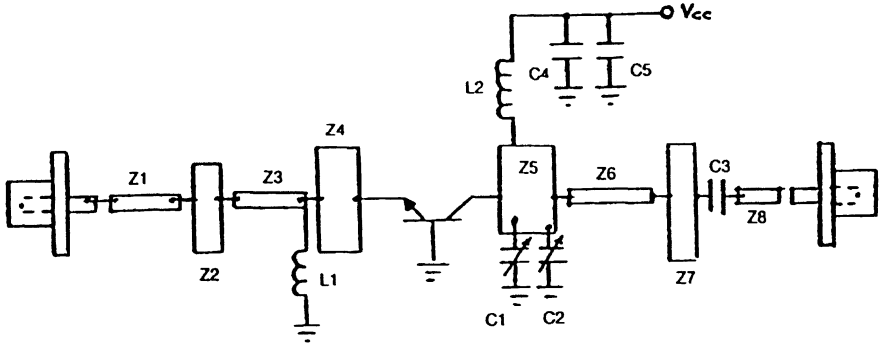
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

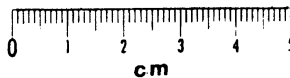
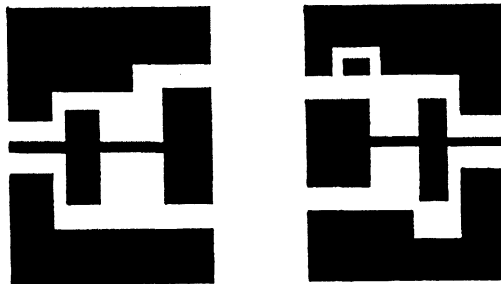
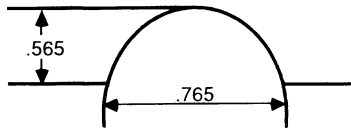


TEST CIRCUIT AND PC BOARD LAYOUT



- C1, C2 : .6 - 4.5pF Gigatrim
- C3 : .100 x .100 120pF Chip Capacitor
- C4 : .100 x .100 470pF Chip Capacitor
- C5 : 100mF Electrolytic
- L1 : #20 AWG
- L2 : 3 Turns, #20 AWG Wound on #32 Drill Bit

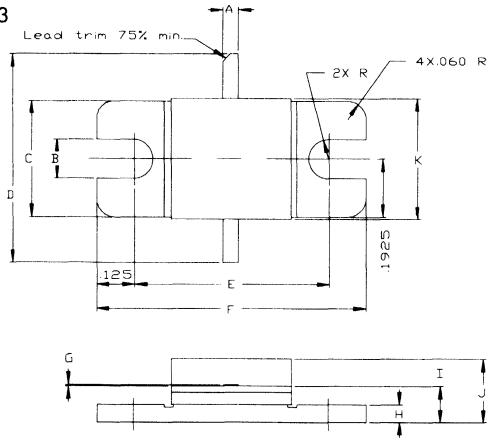
- Z1 : .195 x .415
- Z2 : .685 x .230
- Z3 : .080 x .105
- Z4 : .845 x .345
- Z5 : .640 x .470
- Z6 : .070 x .405
- Z7 : .740 x .180
- Z8 : .50 x .325





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0103



SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.390/9,91	.410/10,41
B	.130/3,30				
C	.380/ 9,65	.390/ 9,91			
D	.880/22,35	.920/23,37			
E	.645/16,38	.655/16,64			
F	.890/22,61	.910/23,11			
G	.002/0,05	.006/0,15			
H	.055/1,40	.065/1,65			
I	.110/2,79	.130/3,30			
J	.190/4,83	.215/5,46			

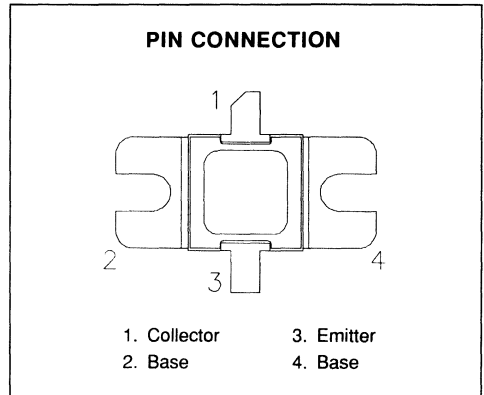
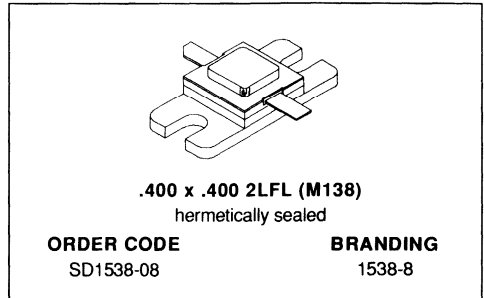


**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSE IFF, DME, AND TACAN APPLICATIONS
- 200 W (typ.) IFF 1030 - 1090 MHz
- 150 W (min.) DME 1025 - 1150 MHz
- 140 W (typ.) TACAN 960 - 1215 MHz
- 8.2 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT AND OUTPUT MATCHED, COMMON BASE CONFIGURATION

**DESCRIPTION**

The SD1538-08 is a gold metallized, silicon NPN power transistor. The SD1538-08 is designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1538-08 is packaged in a metal/ceramic package with internal input/output matching, resulting in improved broadband performance and low thermal resistance.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	11	A
$P_{DISS}$	Power Dissipation	583	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.30	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 300mA$	5	—	—	—

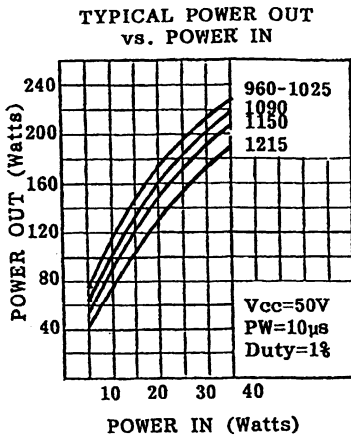
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 25 W$	$V_{CE} = 50 V$	150	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 25 W$	$V_{CE} = 50 V$	8.2	—	—	dB

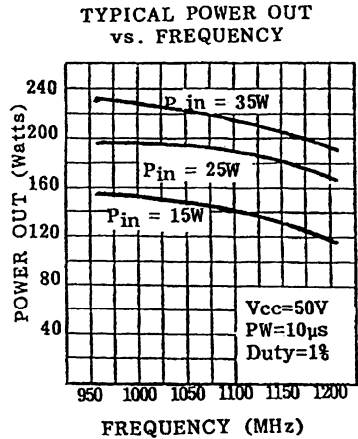
Note: Pulse Width = 10 $\mu$ Sec. Duty Cycle = 1%

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

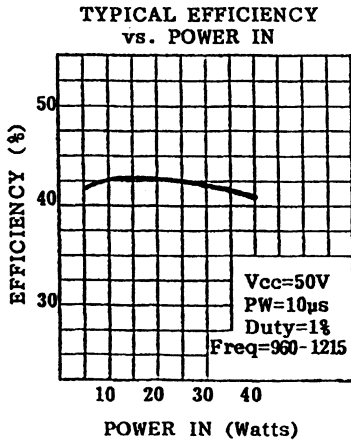


**POWER OUTPUT vs FREQUENCY**

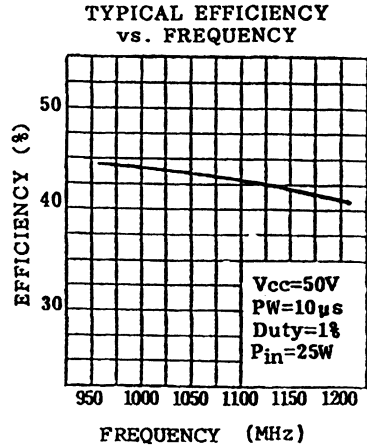


TYPICAL PERFORMANCE (cont'd)

EFFICIENCY vs POWER INPUT

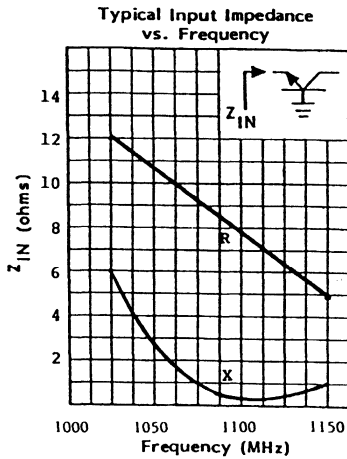


EFFICIENCY vs FREQUENCY

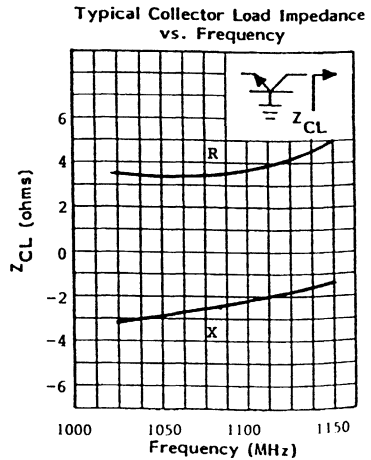


IMPEDANCE DATA

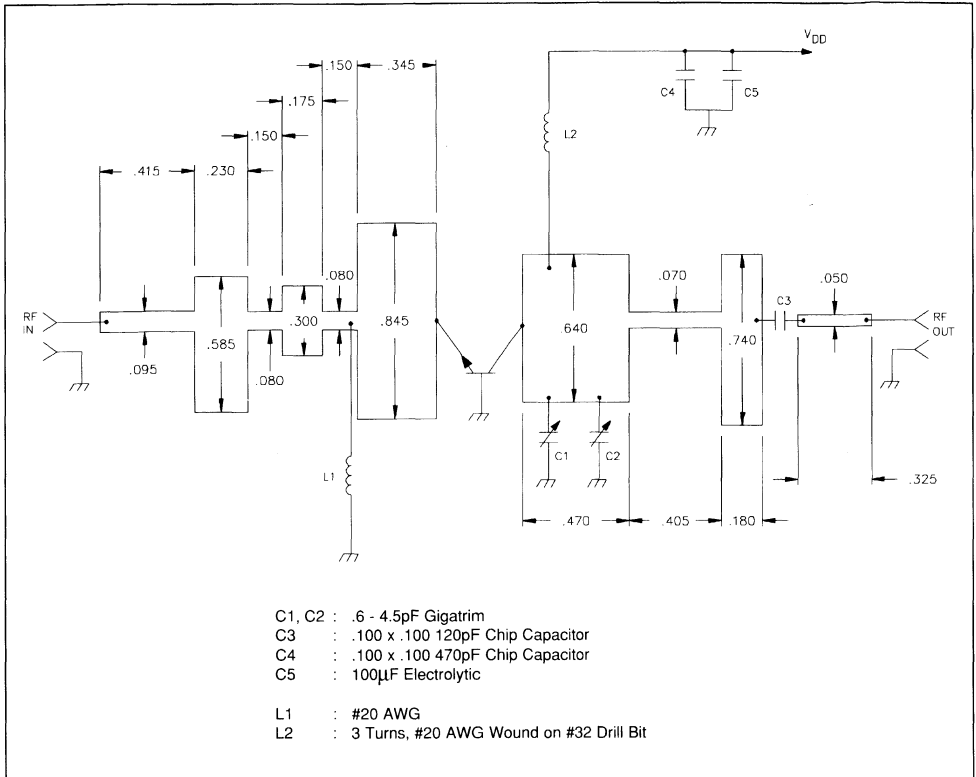
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

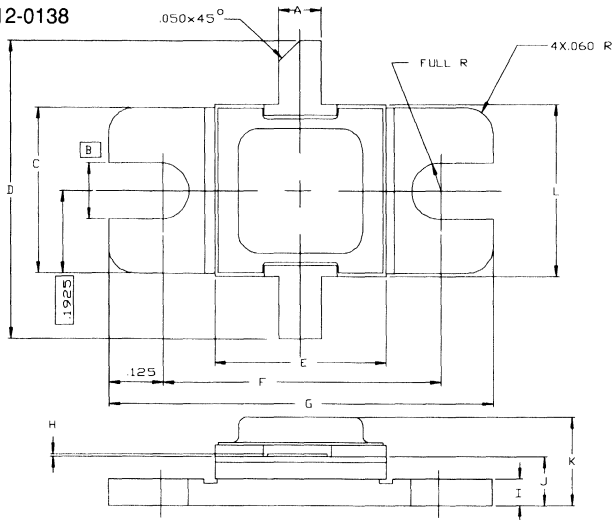


## TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0138



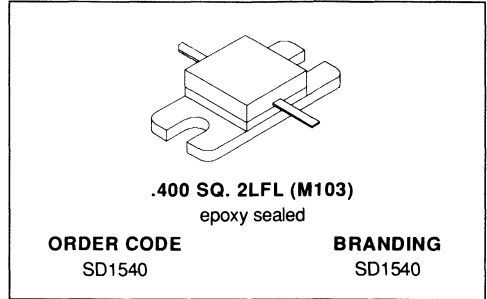
SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	105/2,67	K	.230/5,84
B	.125/3,18		L	.392/9,96
C	.380/9,65	.390/9,91		
D	.780/19,81			
E	.392/9,96	.408/10,36		
F	.645/16,38	.655/16,64		
G	.895/22,73	.905/22,99		
H	.002/0,05	.006/0,15		
I	.055/1,40	.065/1,65		
J	.105/2,67	.130/3,30		



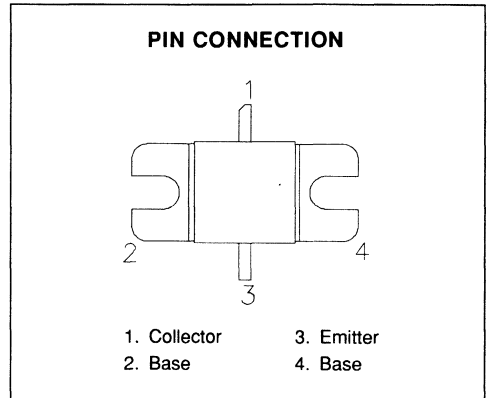


**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 350 WATTS (typ.) IFF 1030 - 1090 MHz
- 300 WATTS (min.) DME 1025 - 1150 MHz
- 2900 WATTS (typ.) TACAN 960 - 1215 MHz
- 6.3 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT/OUTPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1540 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1540 is packaged in a metal/ceramic package with internal input/output matching resulting in improved broadband performance and a low thermal resistance.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_c$	Device Current	22	A
$P_{DISS}$	Power Dissipation	875	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.20	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	25	mA

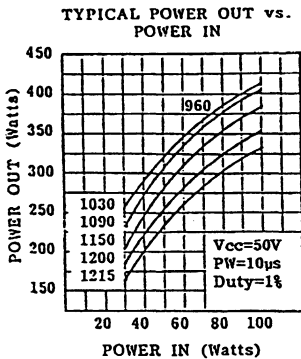
**DYNAMIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 70 W$ $V_{CE} = 50 V$	300	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 70 W$ $V_{CE} = 50 V$	6.3	—	—	dB

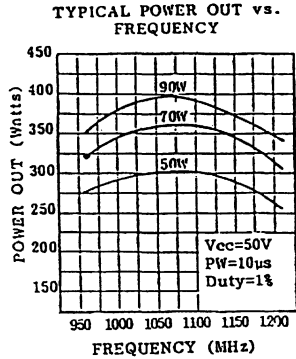
Note: Pulse Width = 10 $\mu$ Sec, Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

**TYPICAL PERFORMANCE**

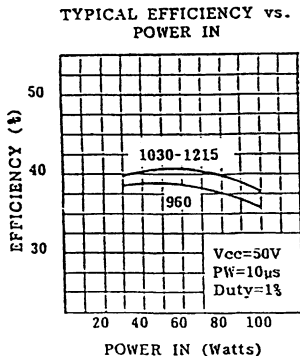
**POWER OUTPUT vs POWER INPUT**



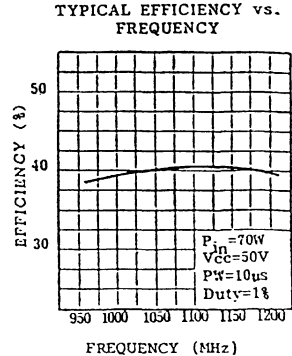
**POWER OUTPUT vs FREQUENCY**



**EFFICIENCY vs POWER INPUT**

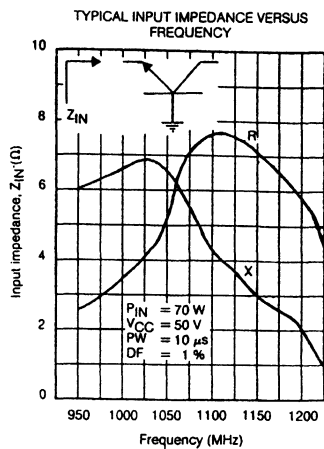


**EFFICIENCY vs FREQUENCY**

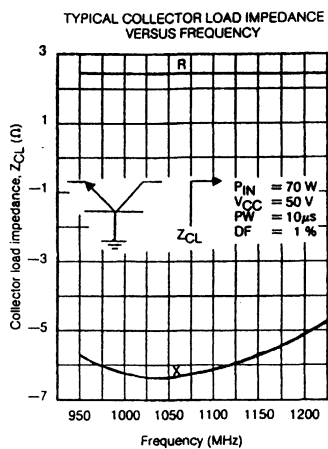


## IMPEDANCE DATA

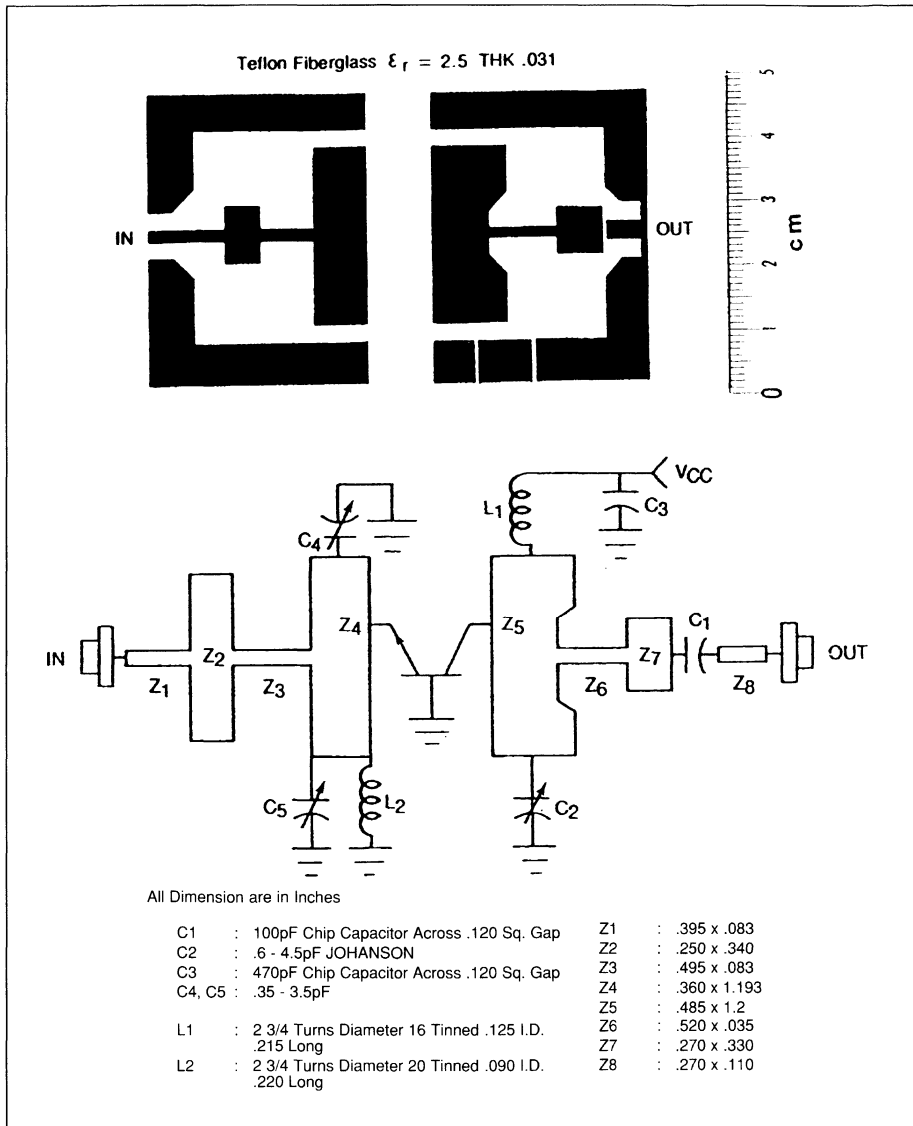
## TYPICAL INPUT IMPEDANCE



## TYPICAL COLLECTOR LOAD IMPEDANCE

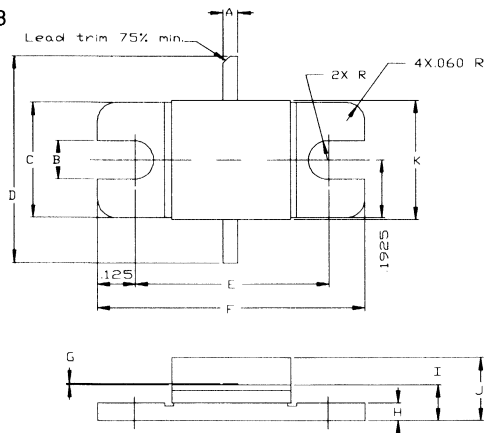


TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0103

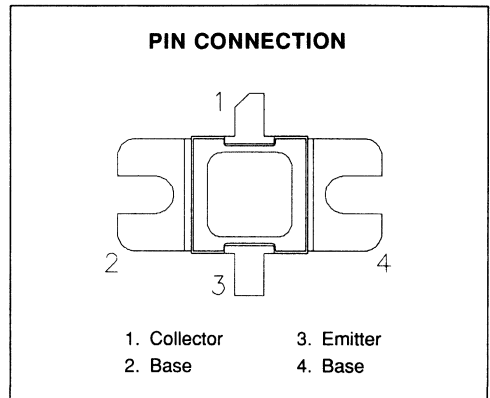
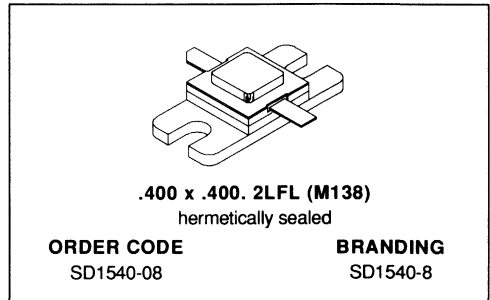


SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.390/9,91 410/10,41
B	.130/3,30			
C	.380/ 9,65	.390/ 9,91		
D	.880/22,35	.920/23,37		
E	.645/16,38	.655/16,64		
F	.890/22,61	.910/23,11		
G	.002/0,05	.006/0,15		
H	.055/1,40	.065/1,65		
I	.110/2,79	.130/3,30		
J	.190/4,83	.215/5,46		



**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 350 WATTS (typ.) IFF 1030 - 1090 MHz
- 300 WATTS (min.) DME 1025 - 1150 MHz
- 290 WATTS (typ.) TACAN 960 - 1215 MHz
- 6.3 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 20:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT/OUTPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1540-08 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1540 is packaged in a metal/ceramic package with internal input/output matching resulting in improved broadband performance and a low thermal resistance.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_c$	Device Current	22	A
$P_{DISS}$	Power Dissipation	875	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.20	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 25mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	10	—	—	—

DYNAMIC

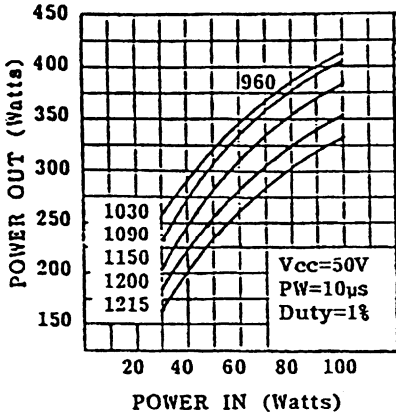
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 70 W$ $V_{CE} = 50 V$	300	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 70 W$ $V_{CE} = 50 V$	6.3	—	—	dB
$\eta_C$	$f = 1025 - 1150MHz$	$P_{IN} = 70 W$ $V_{CE} = 50 V$	35	—	—	%

Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

**TYPICAL PERFORMANCE**

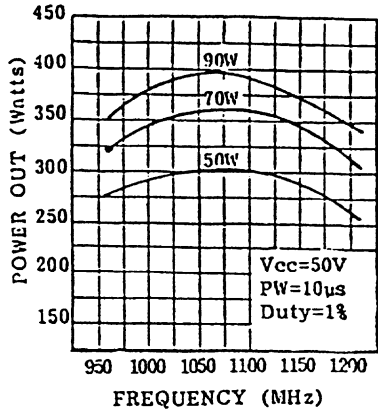
**POWER OUTPUT vs POWER INPUT**

TYPICAL POWER OUT vs. POWER IN



**POWER OUTPUT vs FREQUENCY**

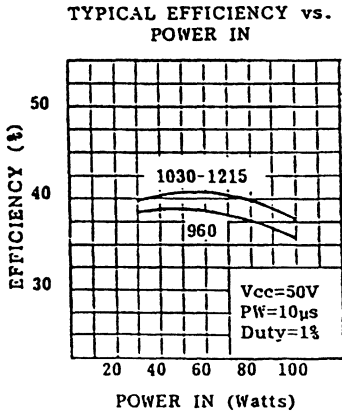
TYPICAL POWER OUT vs. FREQUENCY



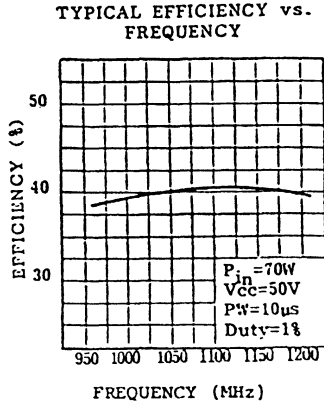


TYPICAL PERFORMANCE (cont'd)

EFFICIENCY vs POWER INPUT

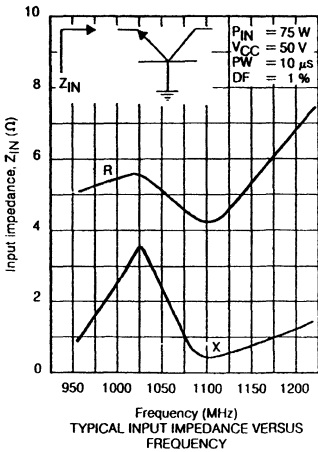


EFFICIENCY vs FREQUENCY

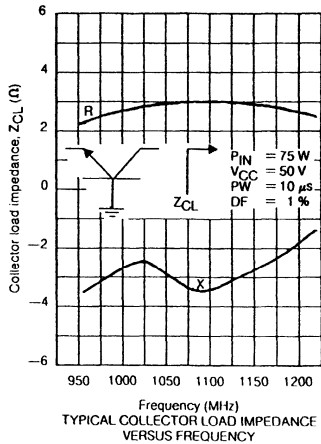


IMPEDANCE DATA

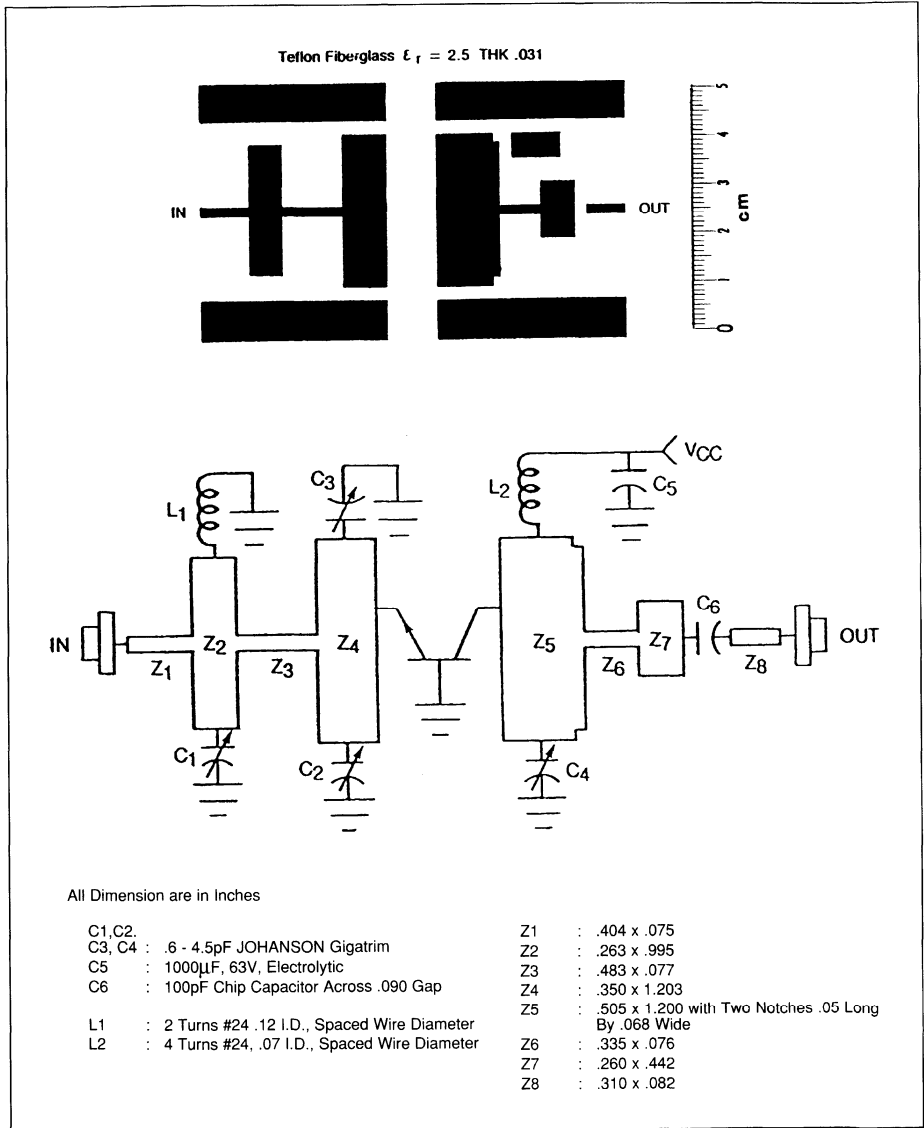
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

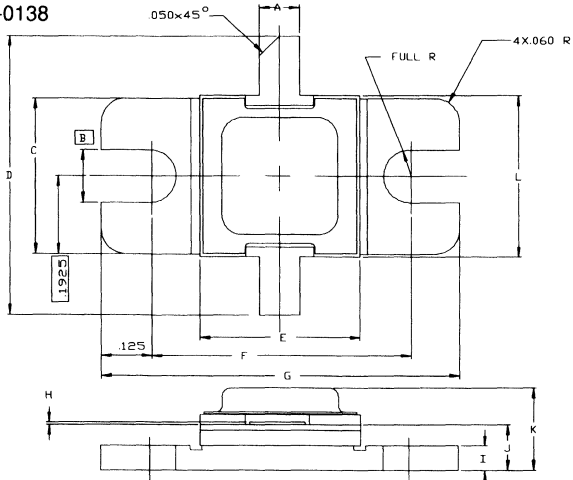


TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0138

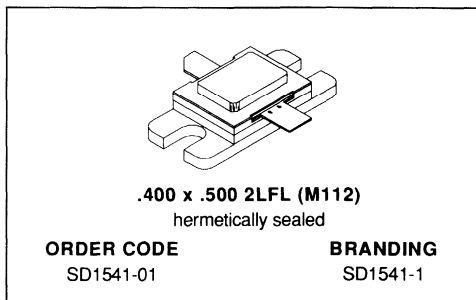


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.095/2,41	.105/2,67	K		.230/5,84
B	.125/3,18		L	.392/9,96	.408/10,36
C	.380/9,65	.390/9,91			
D	.780/19,81				
E	.392/9,96	.408/10,36			
F	.645/16,38	.655/16,64			
G	.895/22,73	.905/22,99			
H	.002/0,05	.006/0,15			
I	.055/1,40	.065/1,65			
J	.105/2,67	.130/3,30			



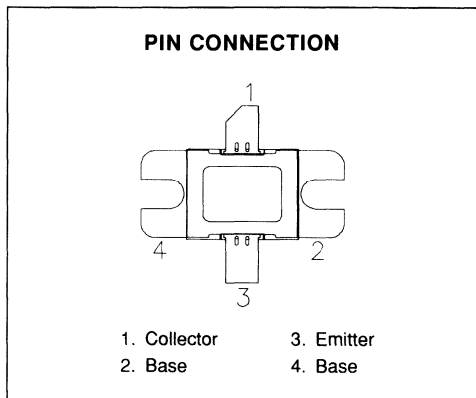
## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- DESIGNED FOR HIGH POWER PULSED IFF AND DME APPLICATIONS
- 400 (min.) DME 1025 - 1150 MHz
- 6.5 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT/OUTPUT MATCHED, COMMON BASE CONFIGURATION



### DESCRIPTION

The SD1541-01 is a hermetically sealed, gold metallized, silicon NPN power transistor. The SD1541-01 is designed for applications requiring high peak power and low duty cycles such as DME. The SD1541-01 is packaged in a hermetic metal/ceramic package with internal input/output matching, resulting in improved broadband performance and a low thermal resistance.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	65	V
V <sub>CES</sub>	Collector-Emitter Voltage	65	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>c</sub>	Device Current	22	A
P <sub>DISS</sub>	Power Dissipation	1458	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	0.12	°C/W
----------------------	----------------------------------	------	------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = .25A$	5	—	200	—

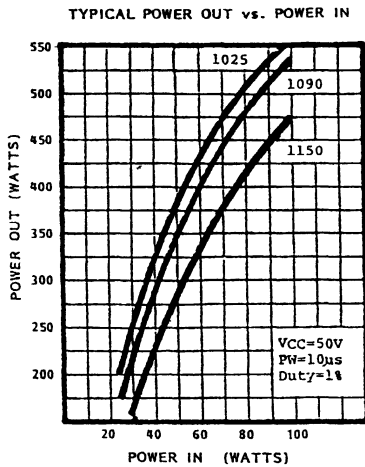
**DYNAMIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 90 W$ $V_{CE} = 50 V$	400	—	—	W
$G_P$	$f = 1025 - 1150MHz$	$P_{IN} = 90 W$ $V_{CE} = 50 V$	6.5	—	—	dB

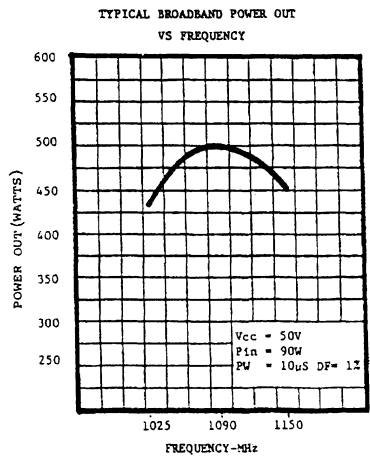
Note: Pulse Width =  $10\mu Sec$ , Duty Cycle = 1%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**



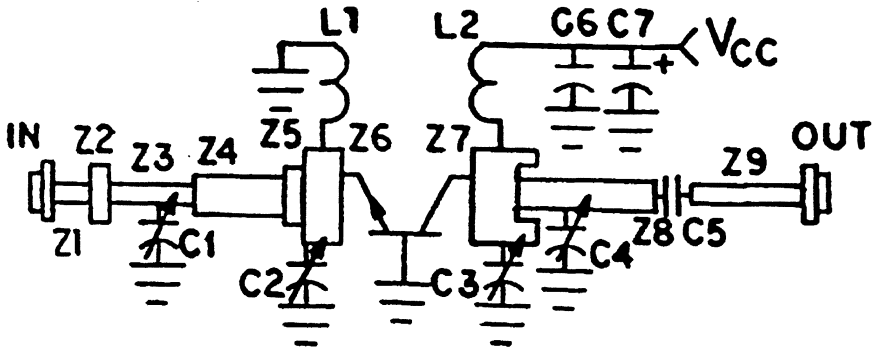
**POWER OUTPUT vs FREQUENCY**



## IMPEDANCE DATA

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1020 MHz	2.898 + j 4.1	1.382 - j 3.2
1090 MHz	2.325 + j 3.4	1.338 - j 2.8
1150 MHz	1.994 + j 2.8	1.269 - j 2.5

## TEST CIRCUIT



All Dimensions in Inches Unless Otherwise specified

C1 : 0.4 - 2.5pF Johanson Gigatrim  
 C2, C3 :  
 C4 : 0.6 - 4.5pF Johanson Gigatrim  
 C5 : 82pF Chip Capacitor, .055 Sq.

L1 : Loop, #18 Tinned, .36 Wide x .27 above Circuit  
 L2 : 4 3/4 Turns, #24 En., C.W., .075 I.D.

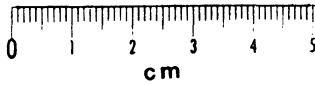
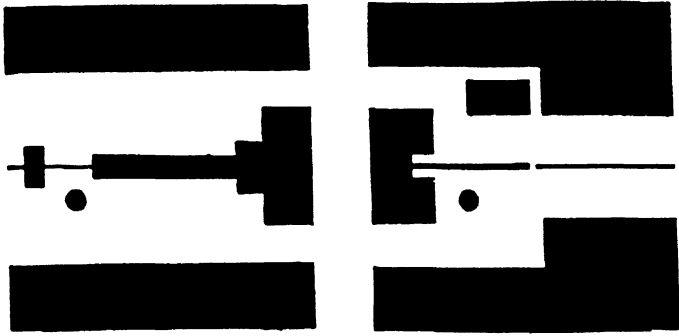
Z1 : 50Ω (.02 Wide)  
 Z2 : .250 x .120

Z3 : 50Ω .020 x .330; C1 tapped .15 from Load  
 Z4 : .145 x .920  
 Z5 : .325 x .180  
 Z6 : .730 x .315  
 Z7 : .710 x .425 with .140 x .150 cutout  
 Z8 : .35 x .780; C4 Tapped .36 from Cen  
 Z9 : 50Ω

C1, C4 : Cold End Terminated Through Eyelet.

PC BOARD LAYOUT

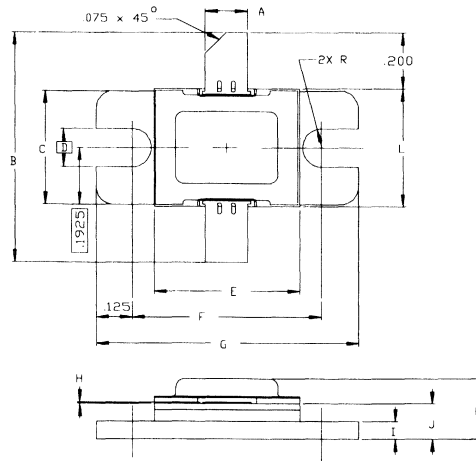
3M EPSILAM 10, .032 THK., 10Z.





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0112

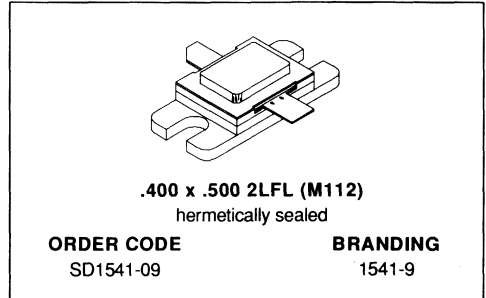


SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.145/3,68	.155/3,93
B	.750/19,05	
C	.380/9,65	.390/9,91
D	.130/3,30	
E	.495/12,57	.507/12,88
F	.640/16,26	.655/16,64
G	.890/22,61	.910/23,11
H	.002/0,05	.006/0,15
I	.055/1,40	.065/1,65
J	.115/2,92	.135/3,43
K		.230/5,84
L	.395/10,03	.407/10,34

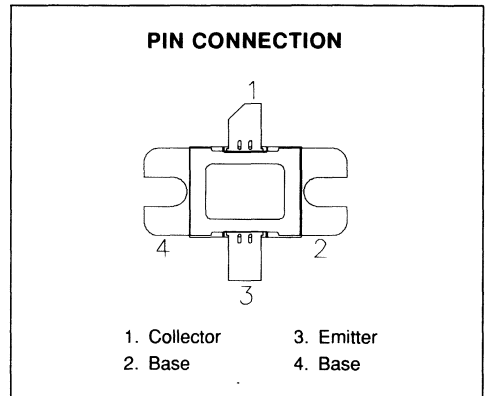


**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF APPLICATIONS
- 450 WATTS (min.) IFF 1030/1090 MHz
- 7.0 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1541-09 is a gold metallized silicon NPN planar transistor. The SD1541-09 is designed for applications requiring high peak and low duty cycles such as IFF. The SD1541-09 is packaged in a metal/ceramic package with internal input matching, resulting in improved broadband performance and a low thermal resistance.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	22	A
$P_{DISS}$	Power Dissipation	1458	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.12	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 50mA$	$I_B = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = .25A$	5	—	200	—

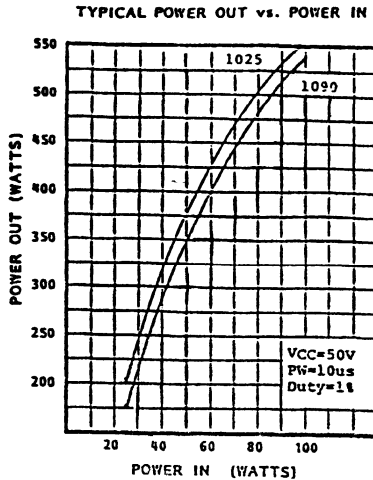
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090\text{ MHz}$	$P_{IN} = 90\text{ W}$	$V_{CE} = 50\text{ V}$	450	—	—	W
$G_P$	$f = 1090\text{ MHz}$	$P_{IN} = 90\text{ W}$	$V_{CE} = 50\text{ V}$	7.0	—	—	dB

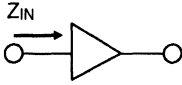
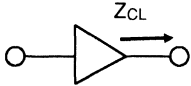
Note: Pulse Width = 10µSec, Duty Cycle = 1%

TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

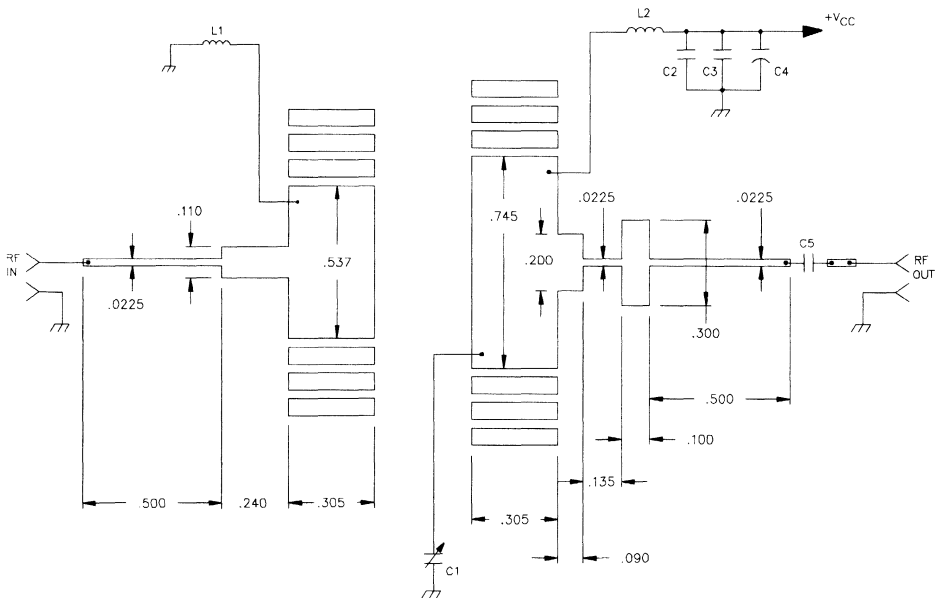


## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
1030 MHz	$1.6 + j 5.1$	$1.1 - j 2.0$
1090 MHz	$2.5 + j 4.7$	$1.2 - j 1.2$

## TEST CIRCUIT LAYOUT



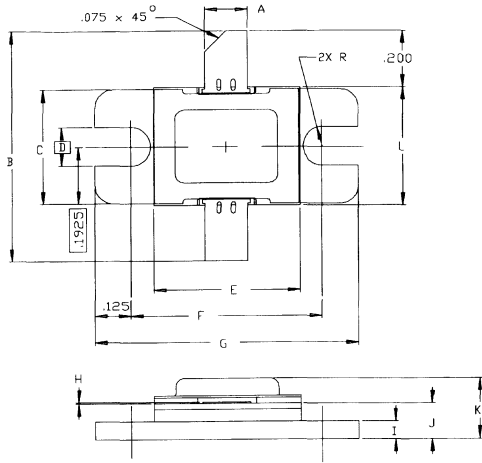
C1 : .4 - 2.5pF Johanson Gigatrim  
 C2 : 100pF Chip Capacitor  
 C3 : .01 $\mu$ F CK05BX103K  
 C4 : 1000 $\mu$ F Electrolytic 63V  
 C5 : 100pF Chip Capacitor

L1 : 1/2 Turn .026" Diameter Wire  
 Loop = .170" Width x .320" Height  
 L2 : 1 Turn .026" Diameter Wire I.D. .130"

All Dimensions are in Inches  
 Board Er = 10.2, Height .025"

PACKAGE MECHANICAL DATA

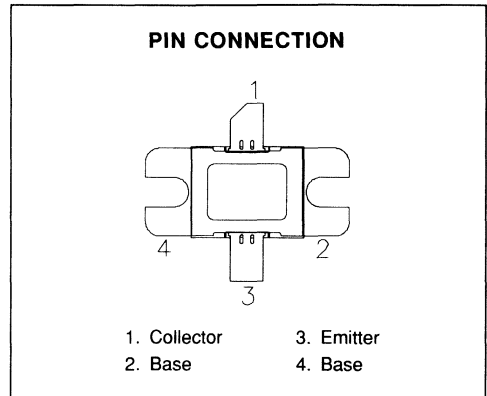
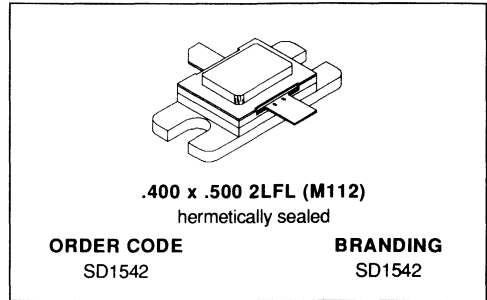
Ref.: Dwg. No.12-0112



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.145/3,68	.155/3,93
B	.750/19,05	
C	.380/9,65	.390/9,91
D	.130/3,30	
E	.495/12,57	.507/12,88
F	.640/16,26	.655/16,64
G	.890/22,61	.910/23,11
H	.002/0,05	.006/0,15
I	.055/1,40	.065/1,65
J	.115/2,92	.135/3,43
K		.230/5,84
L	.395/10,03	.407/10,34

**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF AND DME APPLICATIONS
- 600 WATTS (typ.) IFF 1030/1090 MHz
- 550 WATTS (min.) DME 1025 - 1150 MHz
- 5.6 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INTERNAL INPUT/OUTPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1542 is a hermetically sealed, gold metallized, silicon NPN power transistor. The SD1542 is designed for applications requiring high peak power and low duty cycles such as IFF and DME. The SD1542 is packaged in a hermetic metal/ceramic package with internal input/output matching, resulting in improved broadband performance and a low thermal resistance.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	40	A
$P_{DISS}$	Power Dissipation	1350	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.06	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	35	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = .25A$	5	—	200	—

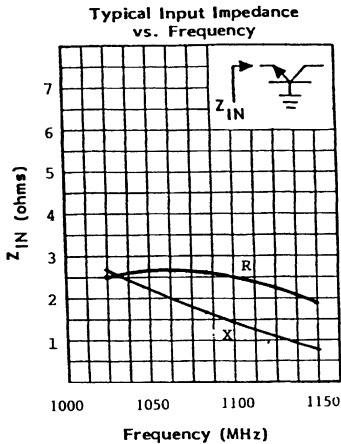
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1025 - 1150MHz$	$P_{IN} = 150 W$	$V_{CE} = 50 V$	550	—	—	W
GP	$f = 1025 - 1150MHz$	$P_{IN} = 150 W$	$V_{CE} = 50 V$	5.6	—	—	dB

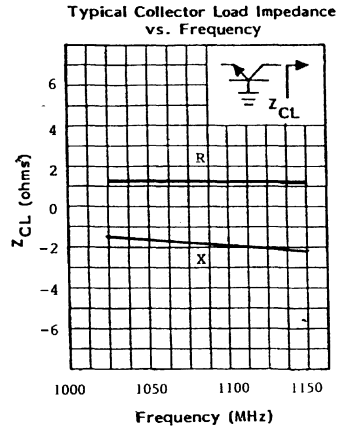
Note: Pulse Width = 10µSec, Duty Cycle = 1%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1020 MHz	1.78 + j 3.0	1.33 - j 2.7
1090 MHz	1.57 + j 2.1	1.64 - j 3.4
1150 MHz	1.55 + j 1.4	1.93 - j 4.0

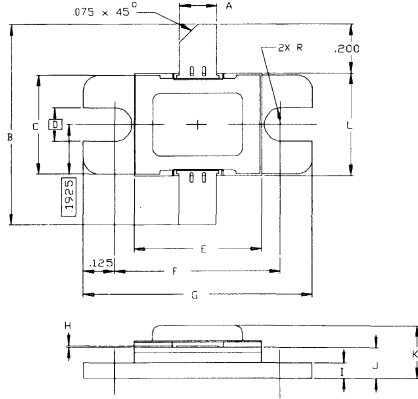
$P_{IN} = 150 W$   
 $V_{CE} = 50 V$





PACKAGE MECHANICAL DATA

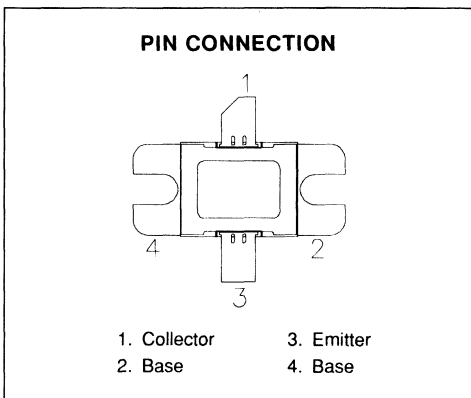
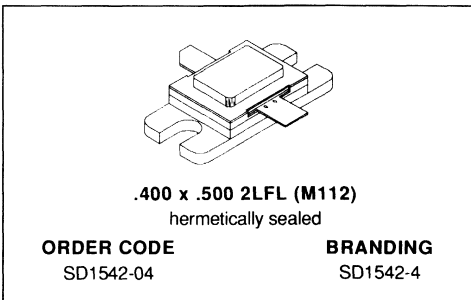
Ref.: Dwg. No.12-0112



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.145/3,68	.155/3,93
B	.750/19,05	
C	.380/9,65	.390/9,91
D	.130/3,30	
E	.495/12,57	.507/12,88
F	.640/16,26	.655/16,64
G	.890/22,61	.910/23,11
H	.002/0,05	.006/0,15
I	.035/1,40	.065/1,65
J	.115/2,92	.135/3,43
K		.230/5,84
L	.395/10,03	.407/10,34

**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF
- 600 WATTS (min.) IFF 1030/1090 MHz
- REFRACTORY GOLD METALLIZATION
- 6.0 dB MIN. GAIN
- BALLASTING AND LOW THERMAL REISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1542-04 is a hermetically sealed, gold metallized, silicon NPN power transistor. The SD1542-04 is designed for applications requiring high peak power and low duty cycles such as IFF. The SD1542-04 is packaged in a hermetic metal/ceramic package with internal input matching, resulting in improved broadband performance and low thermal resistance.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	40	A
$P_{DISS}$	Power Dissipation	1350	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.06	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	35	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	5	—	200	—

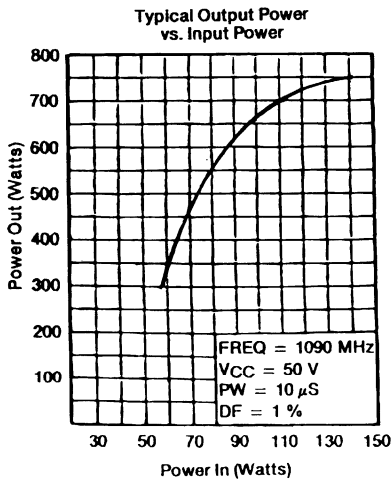
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090\text{ MHz}$	$P_{IN} = 150\text{ W}$	$V_{CE} = 50\text{ V}$	600	—	—	W
$G_P$	$f = 1090\text{ MHz}$	$P_{IN} = 150\text{ W}$	$V_{CE} = 50\text{ V}$	6.0	—	—	dB

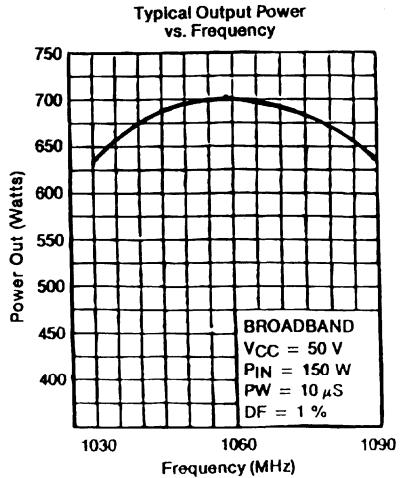
Note: Pulse Width = 10µSec, Duty Cycle = 1%

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**

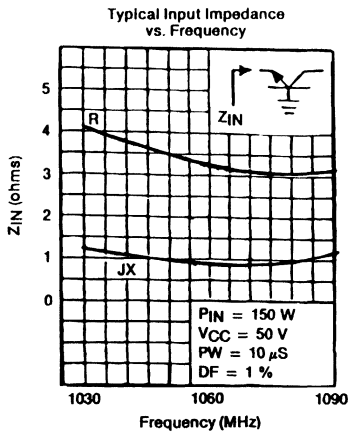


**POWER OUTPUT vs FREQUENCY**

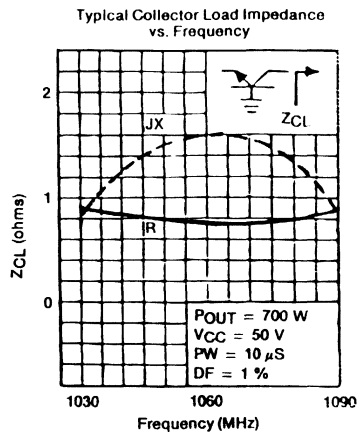


## IMPEDANCE DATA

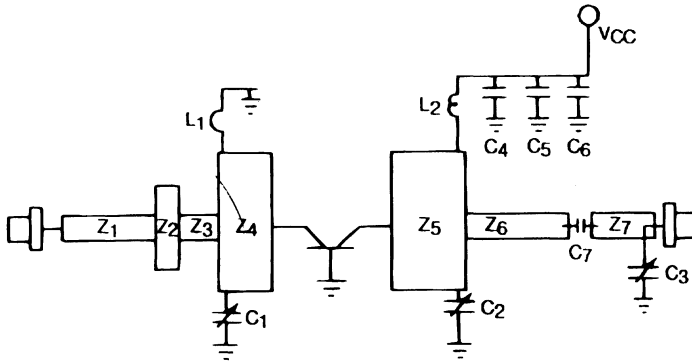
## TYPICAL INPUT IMPEDANCE



## TYPICAL COLLECTOR LOAD IMPEDANCE

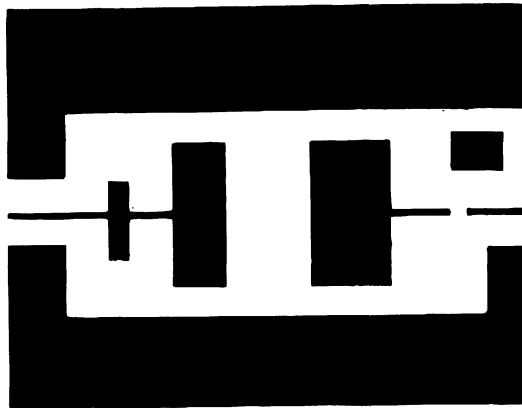


## TEST CIRCUIT



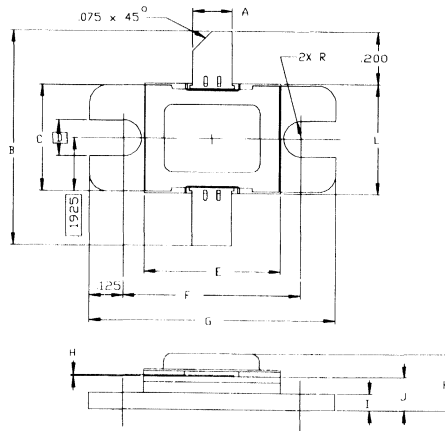
C1, C2,	Z1 :	510 mils x 20mils
C3 :	Z2 :	120mils x 380mils
C4 :	Z3 :	210mils x 20mils
C5 :	Z4 :	270mils x 725mils
C6 :	Z5 :	400mils x 720mils
C7 :	Z6 :	340mils x 20 mils
	Z7 :	245mils x 20 mils
L1 :		
L2 :		

## CIRCUIT BOARD LAYOUT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0112



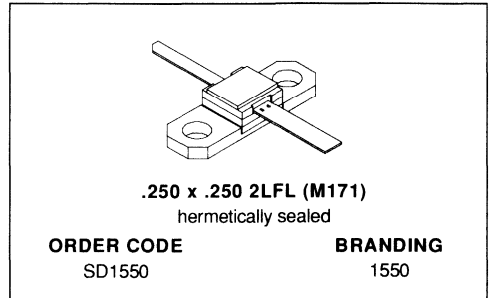
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.145/3,68	.155/3,93
B	.750/19,05	
C	.380/9,65	.390/9,91
D	.130/3,30	
E	.495/12,57	.507/12,88
F	.640/16,26	.655/16,64
G	.890/22,61	.910/23,11
H	.002/0,05	.006/0,15
I	.055/1,40	.065/1,65
J	.115/2,92	.135/3,43
K		.230/5,84
L	.395/10,03	.407/10,34



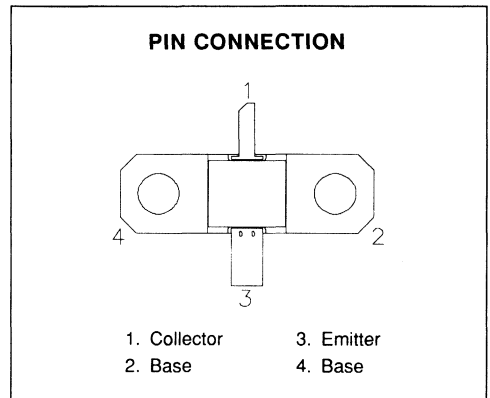


**RF & MICROWAVE TRANSISTORS  
 AVIONICS APPLICATIONS**

- DESIGNED FOR USE IN TACAN SYSTEMS
- EXTREMELY RUGGED
- THERMALLY STABLE
- GOLD METALLIZATION
- $P_{OUT} = 15 \text{ W MIN. WITH } 10.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1550 is a gold metallized silicon NPN planar pulsed transistor that has been designed for use in extended pulse width and duty cycle applications from 960 - 1215 MHz. This device is extremely rugged, thermally stable, and is capable of operation at pulse widths in excess of 20µsec and duty cycles greater than 10%.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	2.0	A
$P_{DISS}$	Power Dissipation	53	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.3	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CES}}$	$I_{\text{C}} = 25\text{mA}$	$V_{\text{BE}} = 0\text{V}$	65	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 10\text{mA}$	$I_{\text{B}} = 0\text{mA}$	30	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 28\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$	20	—	200	—

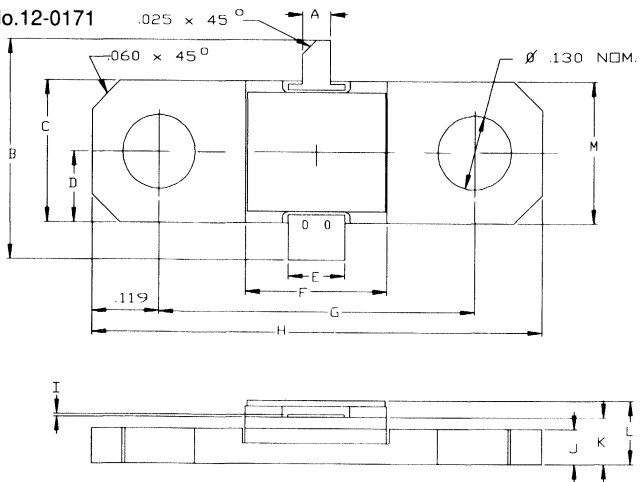
## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 960 \text{ — } 1215 \text{ MHz}$	$P_{\text{IN}} = 1.5 \text{ W}$	$V_{\text{CE}} = 40 \text{ V}$	15	—	—	W
$G_{\text{P}}$	$f = 960 \text{ — } 1215 \text{ MHz}$	$P_{\text{IN}} = 1.5 \text{ W}$	$V_{\text{CE}} = 40 \text{ V}$	10	—	—	dB
$\eta_{\text{C}}$	$f = 960 \text{ — } 1215 \text{ MHz}$	$P_{\text{IN}} = 1.5 \text{ W}$	$V_{\text{CE}} = 40 \text{ V}$	40	—	—	%

Note: Pulse Width =  $20\mu\text{Sec}$ , Duty Cycle = 10%

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0171

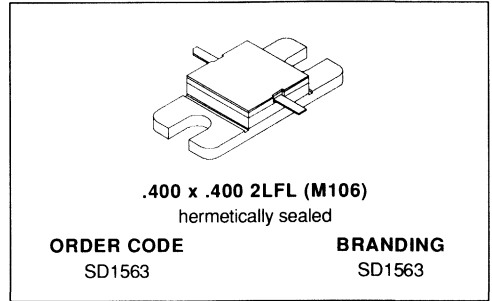


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.076/1,93	.088/2,24
B	.980/24,89		L		.130/3,30
C	.245/6,22	.255/6,48	M	.245/6,22	.258/6,55
D	.125/3,18				
E	.095/2,41	.105/2,67			
F	.245/6,22	.255/6,48			
G	.557/14,15	.567/14,40			
H	.795/20,19	.805/20,45			
I	.002/0,05	.006/0,15			
J	.057/1,45	.067/1,70			

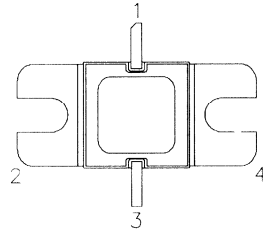


## RF & MICROWAVE TRANSISTORS UHF PULSED APPLICATIONS

- 350 WATTS @ 10μSEC PULSE WIDTH, 10% DUTY CYCLE
- 300 WATTS @ 250μSEC PULSE WIDTH, 10% DUTY CYCLE
- 9.5 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS



### PIN CONNECTION



- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

### DESCRIPTION

The SD1563 is a gold metallized silicon NPN pulse power transistor. The SD1563 is designed for applications requiring high peak power and low duty cycles within the frequency range of 400 - 500 MHz.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	65	V
V <sub>CES</sub>	Collector-Emitter Voltage	65	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>c</sub>	Device Current	21.6	A
P <sub>DISS</sub>	Power Dissipation	875	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	0.2	°C/W
----------------------	----------------------------------	-----	------

**ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 50\text{mA}$	$I_E = 0\text{mA}$	65	—	—	V
$BV_{CES}$	$I_C = 50\text{mA}$	$V_{BE} = 0\text{V}$	65	—	—	V
$BV_{CEO}$	$I_C = 50\text{mA}$	$I_B = 0\text{mA}$	28	—	—	V
$BV_{EBO}$	$I_E = 10\text{mA}$	$I_C = 0\text{mA}$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 30\text{V}$	$I_E = 0\text{mA}$	—	—	7.5	mA
$h_{FE}$	$V_{CE} = 5\text{V}$	$I_C = 5\text{A}$	10	—	100	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 425\text{ MHz}$	$P_{IN} = 33.5\text{ W}$	$V_{CE} = 40\text{ V}$	300	—	—	W
$G_P$	$f = 425\text{ MHz}$	$P_{OUT} = 300\text{ W}$	$V_{CE} = 40\text{ V}$	9.5	—	—	dB
$\eta_C$	$f = 425\text{ MHz}$	$P_{IN} = 25\text{ W}$	$V_{CE} = 40\text{ V}$	55	—	—	%

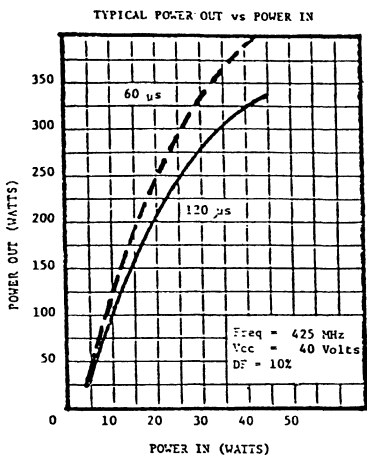
Note: Pulse Width =  $250\mu\text{Sec}$ , Duty Cycle = 10%

**TYPICAL PERFORMANCE**

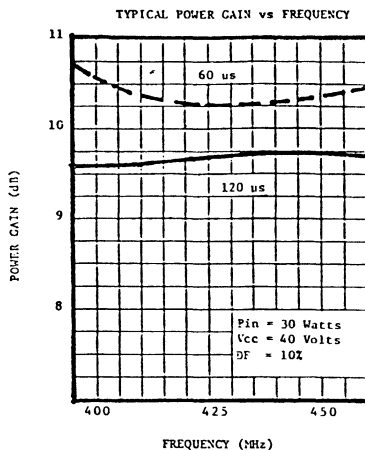
$P_{OUT}$ (W)	P.W. ( $\mu\text{Sec}$ )	D.C. (%)	$T_J$ ( $^{\circ}\text{C}$ max.)	$V_{CC}$
360	10	10	150	40
350	20	10	150	40
325	100	10	150	40
310	500	10	150	40
300	1000	10	150	40

TYPICAL PERFORMANCE (P.W. = 120 $\mu$ Sec)

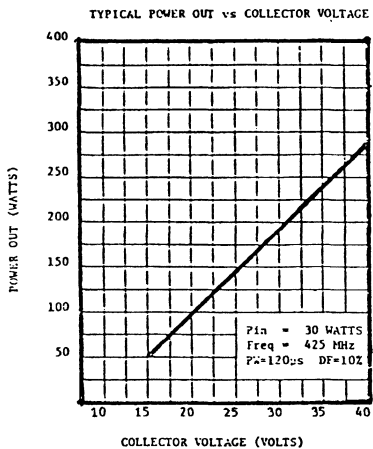
POWER OUTPUT vs POWER INPUT



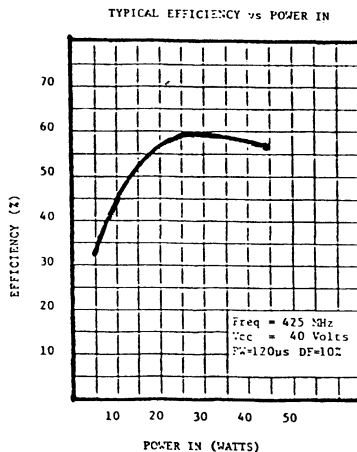
POWER GAIN vs FREQUENCY



POWER OUTPUT vs COLLECTOR VOLTAGE

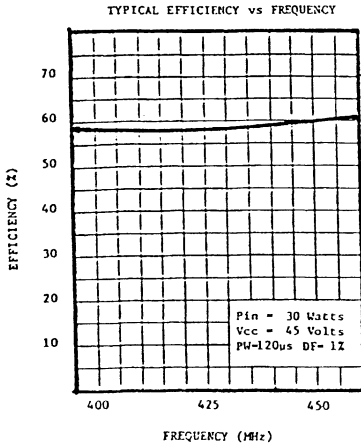


EFFICIENCY vs POWER INPUT

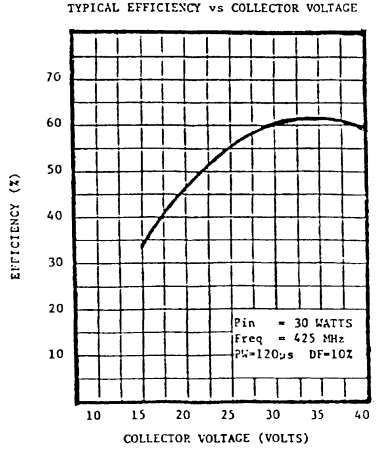


TYPICAL PERFORMANCE (P.W. = 120μSec)

EFFICIENCY vs FREQUENCY

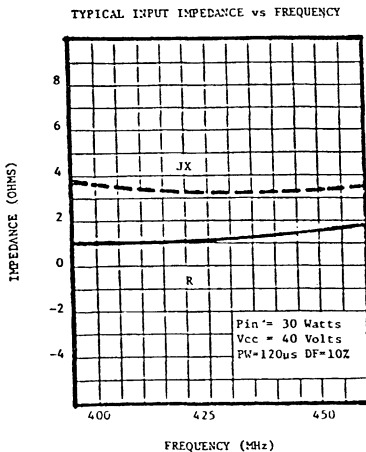


EFFICIENCY vs COLLECTOR VOLTAGE

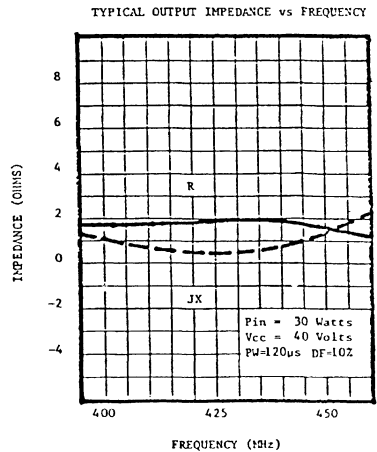


IMPEDANCE DATA (P.W. = 120μSec)

TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

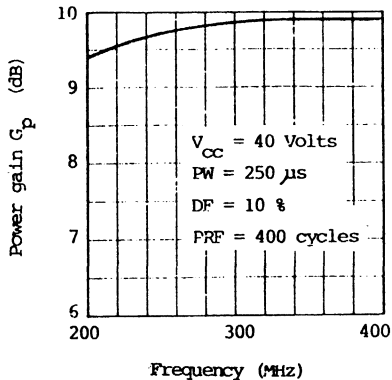




TYPICAL PERFORMANCE (P.W. = 250 $\mu$ Sec)

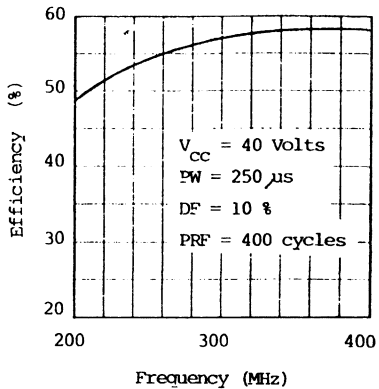
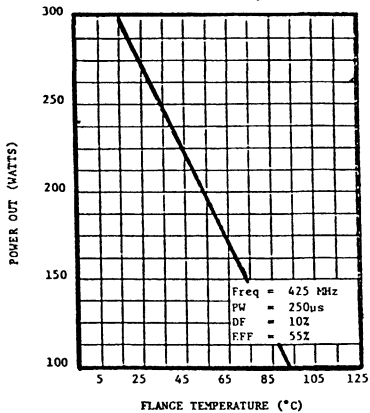
## POWER GAIN vs FREQUENCY

TYPICAL POWER GAIN VS FREQUENCY

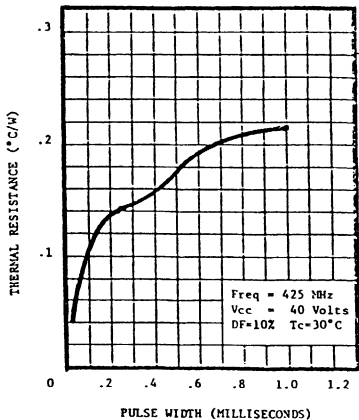


## EFFICIENCY vs FREQUENCY

TYPICAL EFFICIENCY VS FREQUENCY

POWER OUTPUT vs FLANGE  
 $T_J$  @ CONSTANT 125°CTYPICAL POWER OUT vs FLANGE  
TEMPERATURE:  $T_J$  AT CONSTANT 125°C  
PULSE WIDTH: 250 $\mu$ sTHERMAL RESISTANCE vs  
PULSE WIDTH

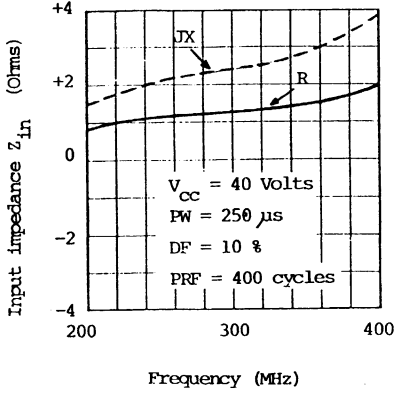
TYPICAL THERMAL RESISTANCE vs PULSE WIDTH



IMPEDANCE DATA (P.W. = 250 $\mu$ Sec)

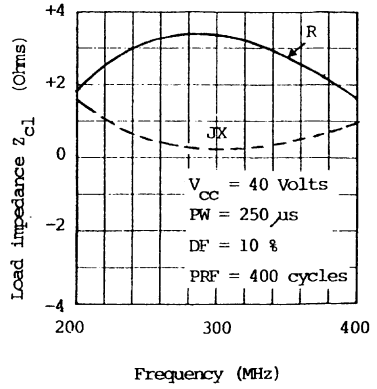
TYPICAL INPUT IMPEDANCE

TYPICAL INPUT IMPEDANCE VS FREQUENCY



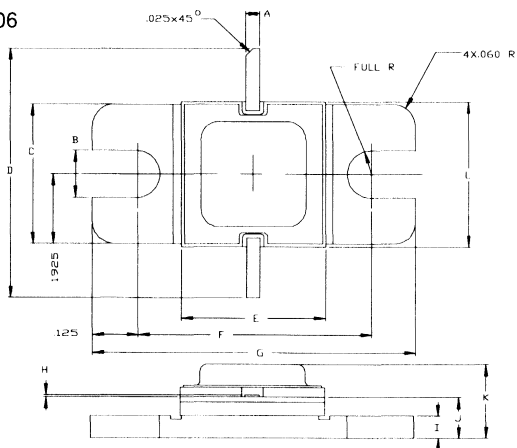
TYPICAL COLLECTOR LOAD IMPEDANCE

TYPICAL LOAD IMPEDANCE VS FREQUENCY



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0106

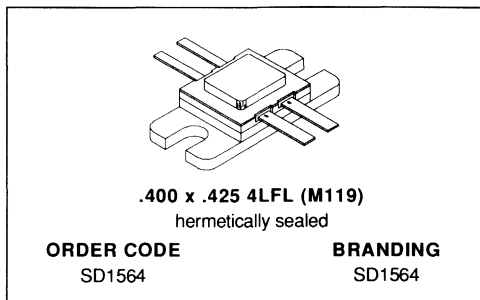


SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.045/1,14	.055/1,40	K	.230/5,84
B	.125/3,18		L	.392/9,96
C	.380/9,65	.390/9,91		
D	.710/18,03			
E	.392/9,96	.402/10,29		
F	.645/16,38	.655/16,64		
G	.895/22,73	.905/22,99		
H	.002/0,05	.006/0,15		
I	.055/1,40	.065/1,65		
J	.105/2,67	.125/3,18		

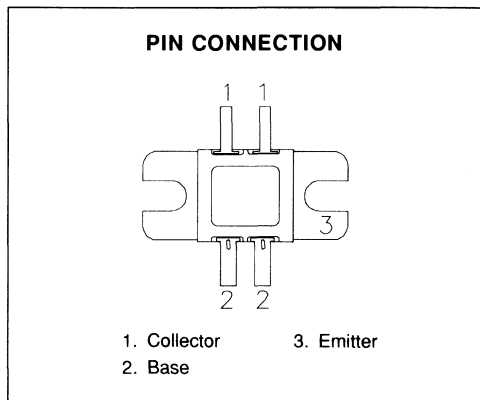


**RF & MICROWAVE TRANSISTORS  
 UHF PULSED APPLICATIONS**

- 400 WATTS @ 60μSEC PULSE WIDTH, 2% DUTY CYCLE
- 7.0 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON EMITTER, BALANCED CONFIGURATION
- HERMETIC PACKAGE


**DESCRIPTION**

The SD1564 is a hermetically sealed, gold metallized silicon NPN pulse power transistor. The SD1564 is designed for applications requiring high peak power and low duty cycles within the frequency range of 400 - 450 MHz.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	28.8	A
$P_{DISS}$	Power Dissipation	1167	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.15	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 50mA	V <sub>BE</sub> = 0V	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 40V	I <sub>E</sub> = 0mA	—	—	20	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500mA	20	—	—	—

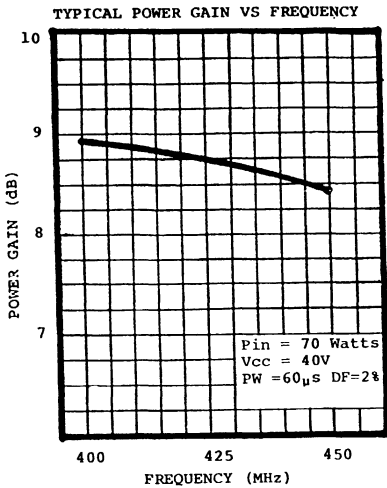
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 425 MHz	P <sub>IN</sub> = 80 W	V <sub>CE</sub> = 40 V	400	—	—	W
G <sub>P</sub>	f = 425 MHz	P <sub>IN</sub> = 80 W	V <sub>CE</sub> = 40 V	7.0	—	—	dB
η <sub>C</sub>	f = 425 MHz	P <sub>IN</sub> = 80 W	V <sub>CE</sub> = 40 V	50	—	—	%

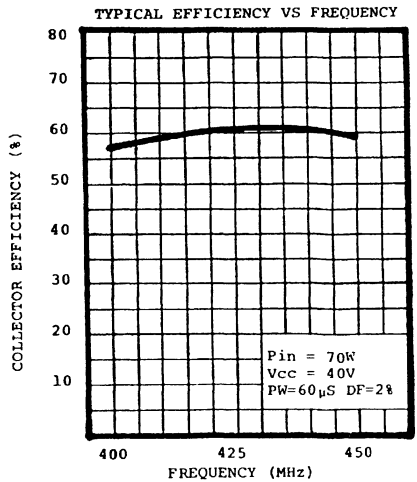
Note: Pulse Width = 60μSec. Duty Cycle = 2%

TYPICAL PERFORMANCE

POWER GAIN vs FREQUENCY



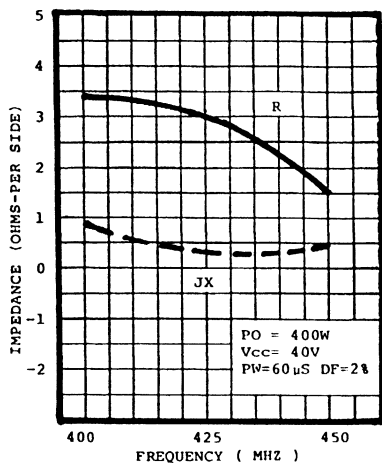
COLLECTOR EFFICIENCY vs FREQUENCY



## IMPEDANCE DATA

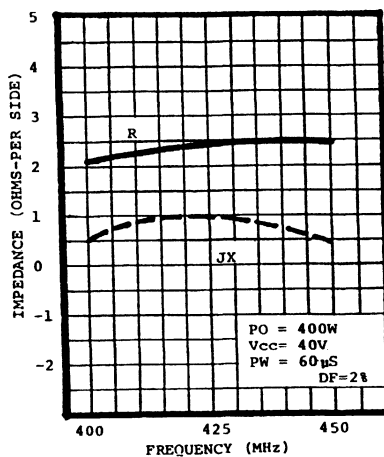
## TYPICAL INPUT IMPEDANCE

TYPICAL INPUT IMPEDANCE VS FREQUENCY



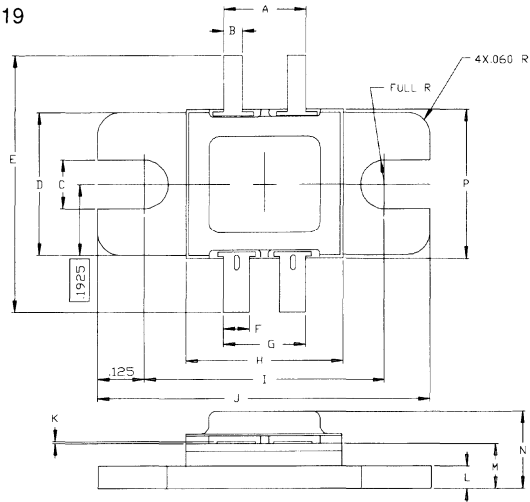
## TYPICAL COLLECTOR LOAD IMPEDANCE

TYPICAL OUTPUT IMPEDANCE VS FREQUENCY



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0119

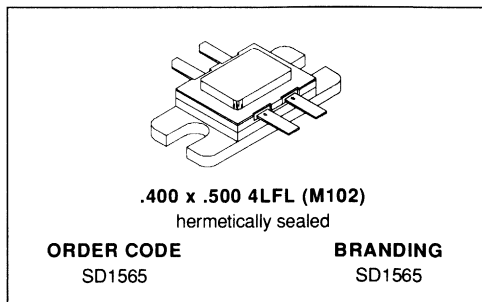


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.210/5,33	.230/5,84	K	.002/0,05	.006/0,15
B	.045/1,14	.055/1,40	L	.058/1,47	.065/1,65
C	.130/3,30		M	.115/2,92	.130/3,30
D	.380/9,65	.390/9,91	N	----	.230/5,84
E	.770/19,56	.830/21,08	P	.395/10,03	.408/10,35
F	.070/1,78	.080/2,03			
G	.215/5,46	.235/5,97			
H	.420/10,67	.433/11,00			
I	.645/16,38	.655/16,64			
J	.895/22,73	.905/22,99			

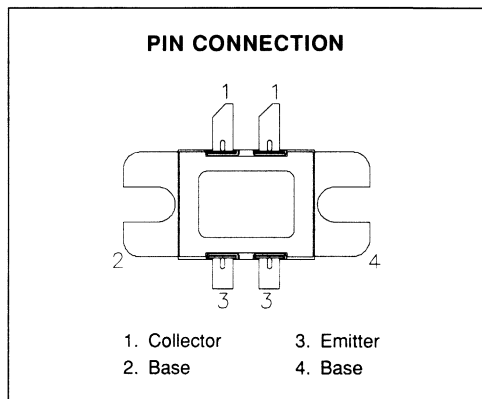


**RF & MICROWAVE TRANSISTORS  
 UHF PULSED APPLICATIONS**

- 500 WATTS @ 250 $\mu$ Sec PULSE WIDTH, 10% DUTY CYCLE
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION
- BALANCED CONFIGURATION


**DESCRIPTION**

The SD1565 is a hermetically sealed, gold metallized silicon NPN pulse power transistor mounted in a common base balanced configuration. The SD1565 is designed for applications requiring high peak power and low duty cycles within the frequency range of 400 - 500 MHz.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	43.2	A
$P_{DISS}$	Power Dissipation	1167	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.15	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 50mA	I <sub>E</sub> = 0mA	65	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 50mA	V <sub>BE</sub> = 0V	65	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	3.5	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 30V	I <sub>E</sub> = 0mA	—	—	15	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 5A	20	—	200	—

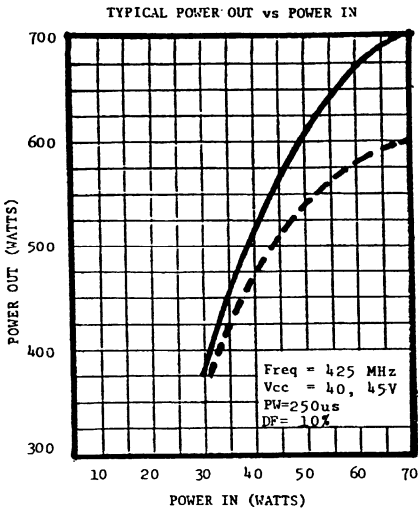
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 425 MHz	P <sub>IN</sub> = 54 W	V <sub>CE</sub> = 40 V	500	—	—	W
G <sub>P</sub>	f = 425 MHz	P <sub>IN</sub> = 54 W	V <sub>CE</sub> = 40 V	9.7	—	—	dB
η <sub>C</sub>	f = 425 MHz	P <sub>IN</sub> = 54 W	V <sub>CE</sub> = 40 V	50	—	—	%

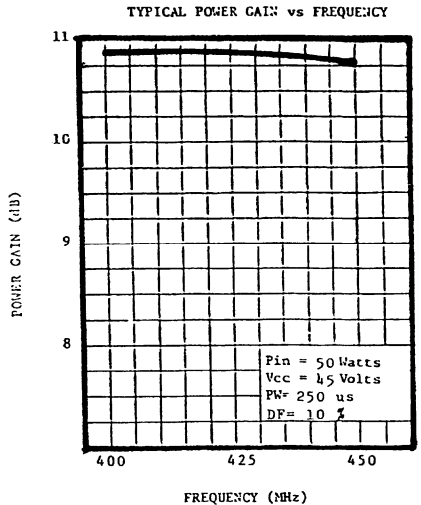
Note: Pulse Width = 250µSec. Duty Cycle = 10%  
 This device is suitable for use under other pulse width/duty cycle conditions.  
 Please contact the factory for specific applications assistance.

TYPICAL PERFORMANCE (P.W. = 250µS, D.C. = 10%)

POWER OUTPUT vs POWER INPUT

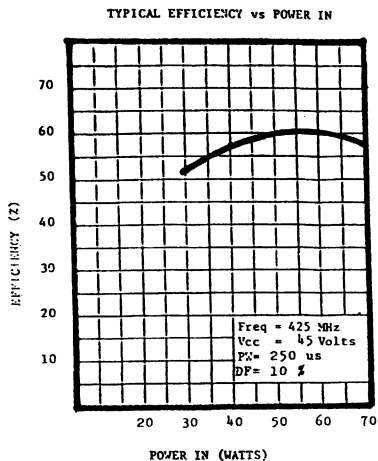


POWER GAIN vs FREQUENCY

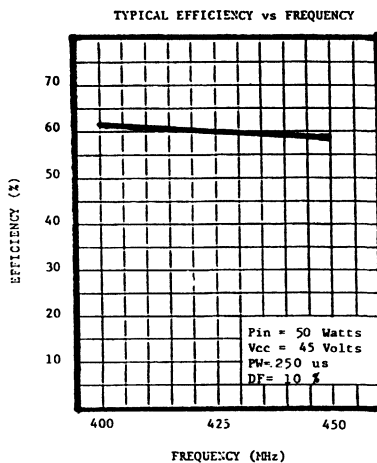


TYPICAL PERFORMANCE (P.W. = 250μS, D.C. = 10%)

EFFICIENCY vs POWER INPUT

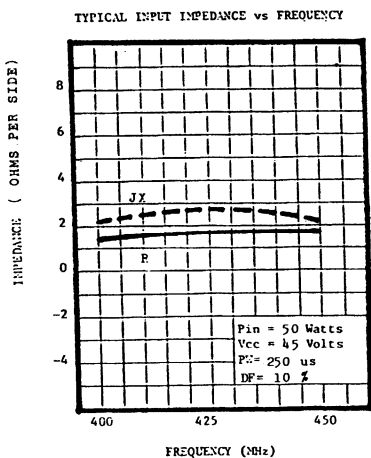


EFFICIENCY vs FREQUENCY

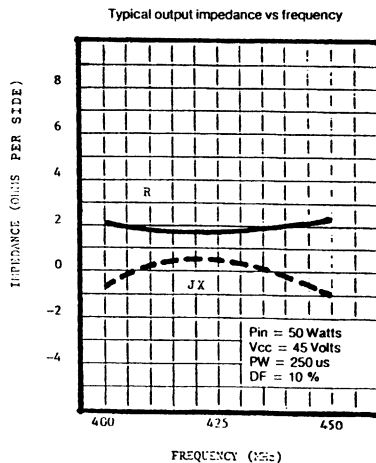


IMPEDANCE DATA (P.W. = 250μS, D.C. = 10%)

TYPICAL INPUT IMPEDANCE

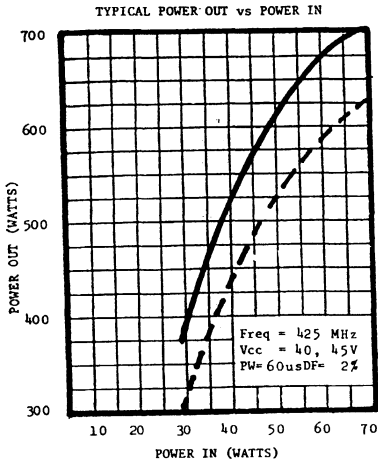


TYPICAL COLLECTOR LOAD IMPEDANCE

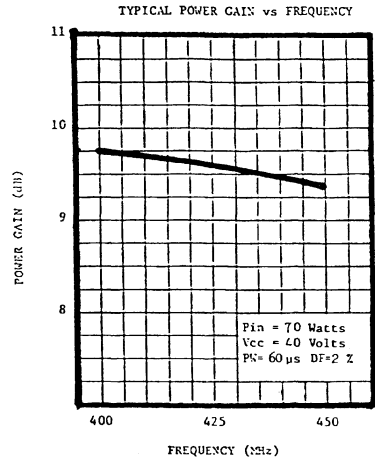


TYPICAL PERFORMANCE (P.W. = 60μS, D.C. = 2%)

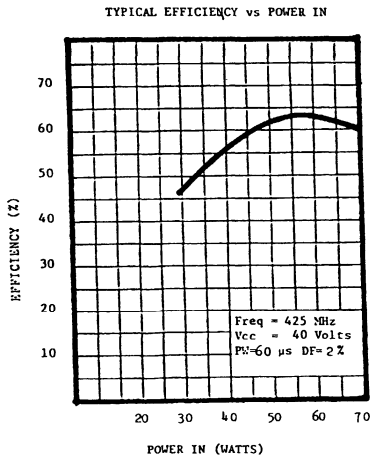
POWER OUTPUT vs POWER INPUT



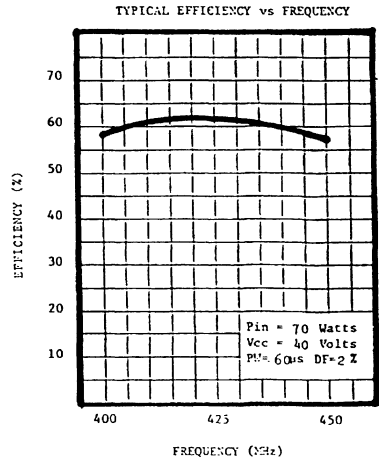
POWER GAIN vs FREQUENCY



EFFICIENCY vs POWER INPUT

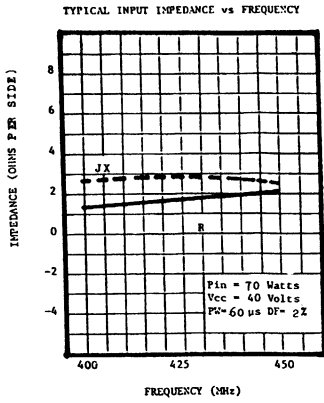


EFFICIENCY vs FREQUENCY

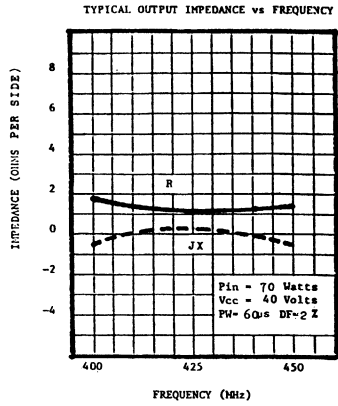


IMPEDANCE DATA (P.W. = 60μS, D.C. = 2%)

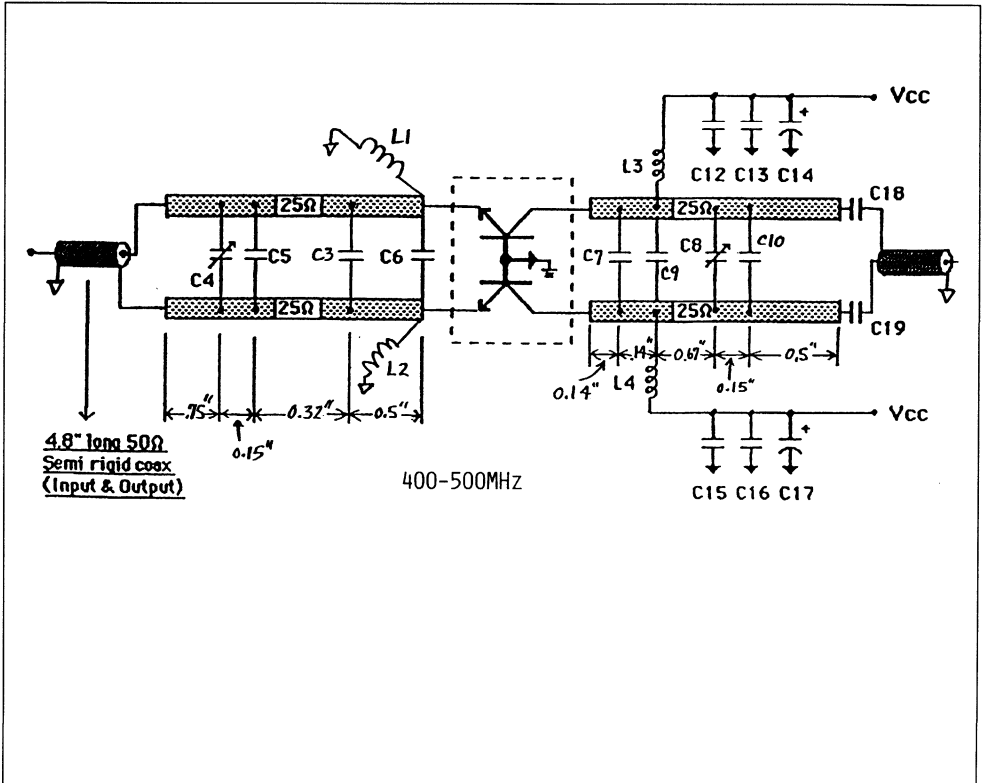
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE

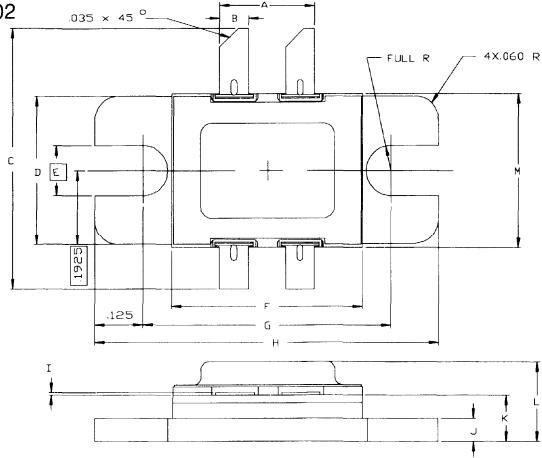


TEST CIRCUIT



PACKAGE MECHANICAL DATA

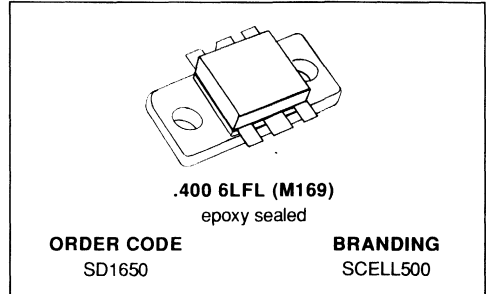
Ref.: Dwg. No.12-0102



SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.240/6,10	.254/6,45	K	.115/2,92	.130/3,30
B	.070/1,78	.080/2,03	L	---	.230/5,84
C	.780/19,81	.820/20,83	M	.395/10,03	.407/10,34
D	.380/9,65	.390/9,91			
E	.130/3,30				
F	.495/12,57	.507/12,88			
G	.640/16,26	.655/16,64			
H	.890/22,61	.910/23,11			
I	.002/0,05	.006/0,15			
J	.058/1,47	.065/1,65			

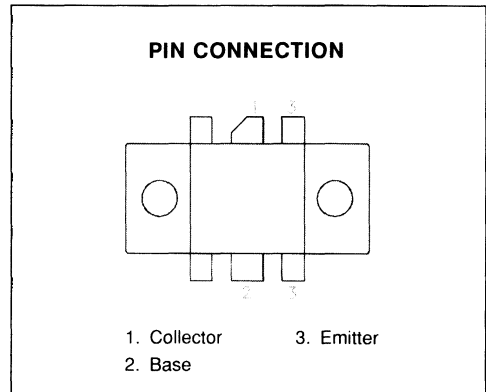
## RF & MICROWAVE TRANSISTORS CELLULAR BASE STATION APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- DOUBLE STEP INPUT/OUTPUT MATCH
- 850-960 MHz CLASS AB LINEAR
- COMMON EMITTER
- $P_{OUT} = 60$  W MIN. WITH 7 dB MIN GAIN



### DESCRIPTION

Designed for 900 MHz cellular radio base station applications, the SD1650 exhibits high collector efficiency with excellent thermal characteristics. Double-section internal input/output matching result in terminal impedance levels easily handled by the circuit designer.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	28	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	10	A
$P_{DISS}$	Power Dissipation (+25°C)	175	W
$T_J$	Junction Temperature	+200	°C
$T_{STG}$	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.5	°C/W
---------------	----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

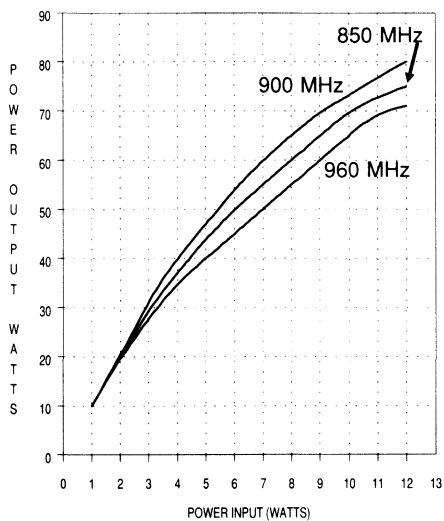
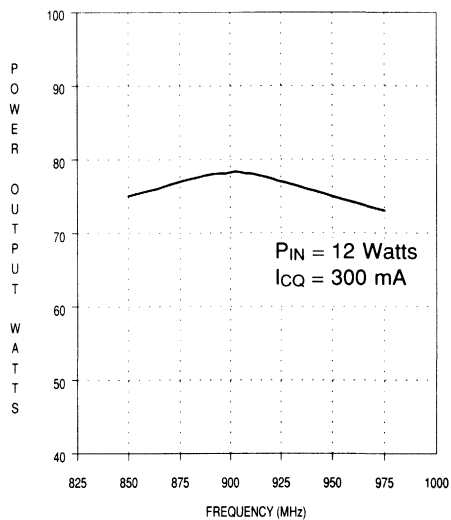
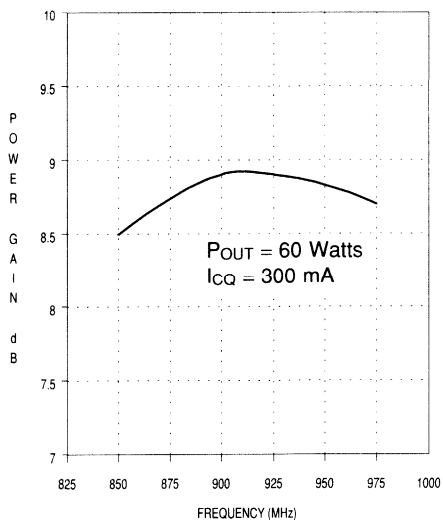
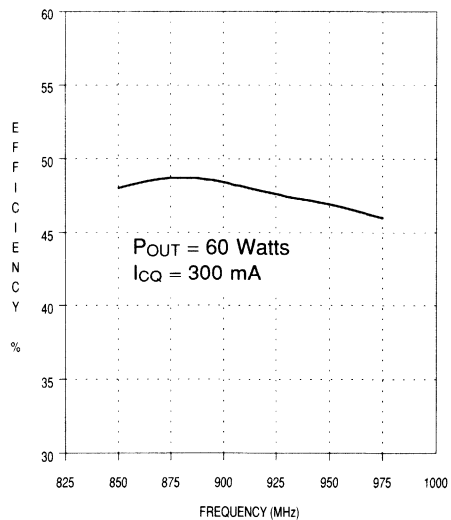
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	60	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 20\text{mA}$	3.0	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 100\text{mA}$	60	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 100\text{mA}$	28	—	—	V
$I_{\text{CEO}}$	$V_{\text{CE}} = 24\text{V}$	—	—	10	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$ $I_{\text{C}} = 6\text{A}$	20	—	200	—

## DYNAMIC

Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 900\text{ MHz}$ $P_{\text{IN}} = 12\text{ W}$ $I_{\text{CQ}} = 300\text{ mA}$	60	—	—	W
$\eta_{\text{C}}$	$f = 900\text{ MHz}$ $P_{\text{IN}} = 12\text{ W}$ $I_{\text{CQ}} = 300\text{ mA}$	45	—	—	%
$G_{\text{P}}$	$f = 900\text{ MHz}$ $P_{\text{IN}} = 12\text{ W}$ $I_{\text{CQ}} = 300\text{ mA}$	7	—	—	dB
VSWR	$f = 900\text{ MHz}$ $P_{\text{IN}} = 12\text{ W}$	3:1	—	—	—

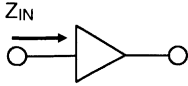


## TYPICAL PERFORMANCE

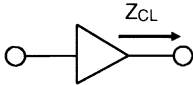
BROADBAND POWER OUTPUT  
vs POWER INPUTBROADBAND POWER OUTPUT  
vs FREQUENCYBROADBAND POWER GAIN  
vs FREQUENCYBROADBAND EFFICIENCY  
vs FREQUENCY

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

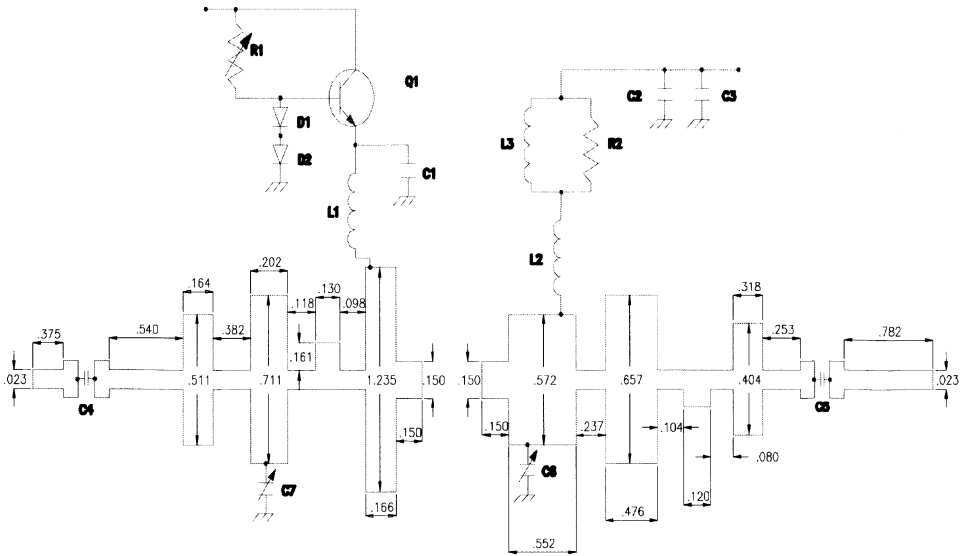


TYPICAL COLLECTOR LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
850 MHz	2.4 + j 5.2	4.0 - j 1.3
870 MHz	2.6 + j 5.4	3.9 - j 2.3
900 MHz	3.2 + j 6.3	3.6 - j 2.6
930 MHz	4.1 + j 6.0	3.4 - j 2.4
960 MHz	4.7 + j 5.6	3.0 - j 3.0

TEST CIRCUIT

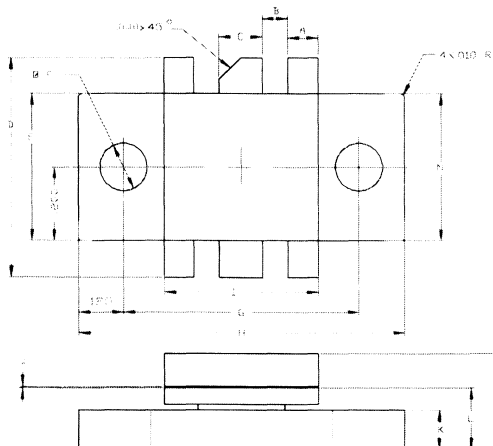


- C1,C2 : 220 pF Chip Capacitor ATC Size B
- C3 : 10 Microfarad Electrolytic Capacitor
- C4,C5 : 220 pF Chip Capacitor ATC Size B
- C6,C7 : 1 - 4 pF Johanson Variable Capacitor
- D1,D2 : 1N3064 Diode or Equiv

- L1,L2 : 5 Turn 1/4" Dia. 16 AWG Coil
- Q1 : SD1438-02 or Equiv.
- R1 : 5KΩ Potentiometer
- R2 : 100Ω 1/4 Watt Resistor
- Er = 10.2 H = .025in.

## PACKAGE MECHANICAL DATA

Ref. Dwg. No.: 12-0169

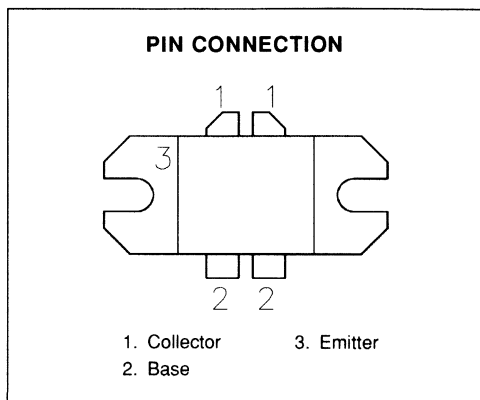
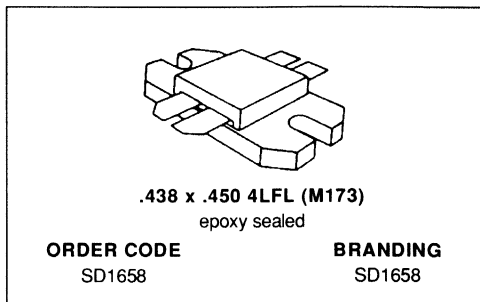


	SGS-THOMSON MICROELECTRONICS		UNIT: D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	0.78 ± 0.05	0.83 ± 0.024	K	0.05 ± 0.07
B	0.20 ± 0.05		L	0.09 ± 0.04
C	0.15 ± 0.02	0.25 ± 0.16	M	0.60 ± 0.11
D	0.60 ± 0.05	0.25 ± 0.025	N	0.95 ± 0.03
E	0.90 ± 0.03	1.10 ± 0.029		
F	1.25 ± 0.03			
G	1.20 ± 0.03	1.10 ± 0.04		
H	0.70 ± 0.04	0.60 ± 0.04		
I	0.60 ± 0.07	0.50 ± 0.07		
J	0.60 ± 0.05	0.67 ± 0.10		



**RF & MICROWAVE TRANSISTORS**  
**800/900 MHz APPLICATIONS**

- 860 - 900 MHz
- 24 VOLTS
- CLASS AB PUSH PULL
- INTERNAL INPUT MATCHED
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- GOLD METALLIZATION
- DIFFUSED EMITTER BALLAST RESISTORS
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = 40 \text{ W MIN. WITH } 6.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1658 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in cellular base station applications.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_c$	Device Current	8.0	A
$P_{DISS}$	Power Dissipation	175	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

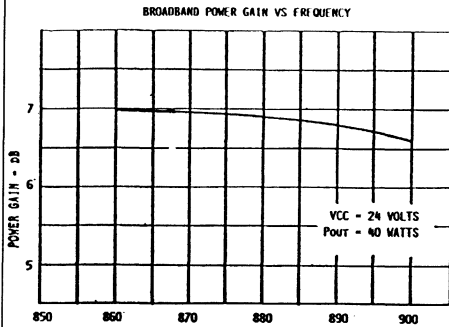
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{E}} = 0\text{mA}$	45	—	—	V
$BV_{\text{CER}}$	$I_{\text{C}} = 20\text{mA}$	$R_{\text{BE}} = 10\Omega$	40	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 200\text{mA}$	$I_{\text{B}} = 0\text{mA}$	30	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.0	—	—	V
$I_{\text{CEO}}$	$V_{\text{CE}} = 28\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 3\text{A}$	10	—	80	—

## DYNAMIC

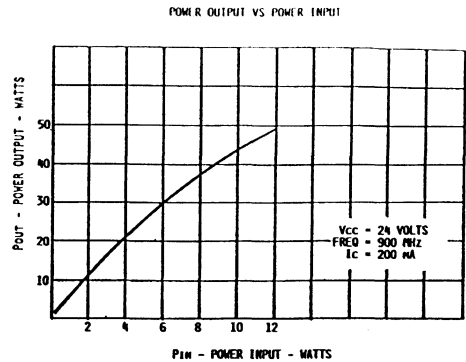
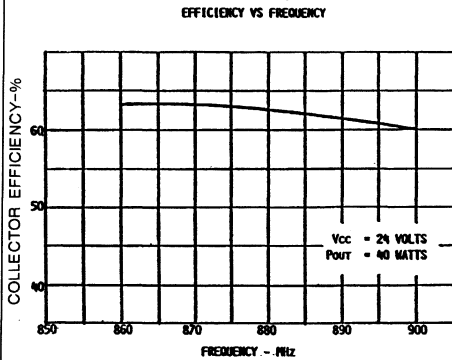
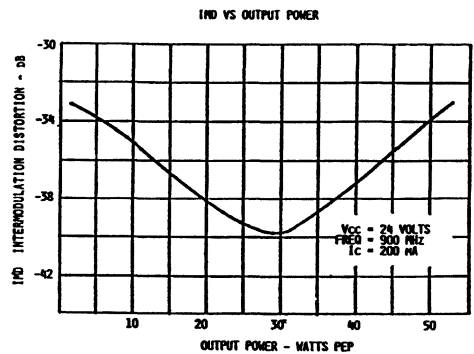
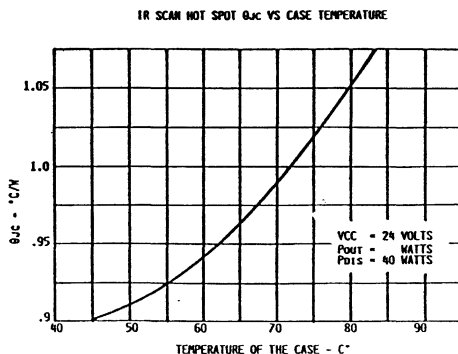
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}^*$	$f = 900\text{ MHz}$	$V_{\text{CE}} = 24\text{ V}$	$I_{\text{CQ}} = 2 \times 250\text{ mA}$	40	—	—	W
$G_{\text{P}}^*$	$f = 900\text{ MHz}$	$V_{\text{CE}} = 24\text{ V}$	$I_{\text{CQ}} = 2 \times 250\text{ mA}$	6.0	—	—	dB
$\eta_{\text{C}}^*$	$f = 900\text{ MHz}$	$V_{\text{CE}} = 24\text{ V}$	$I_{\text{CQ}} = 2 \times 250\text{ mA}$	40	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		60	—	80	pF

Note: \* @ 1 dB Compression

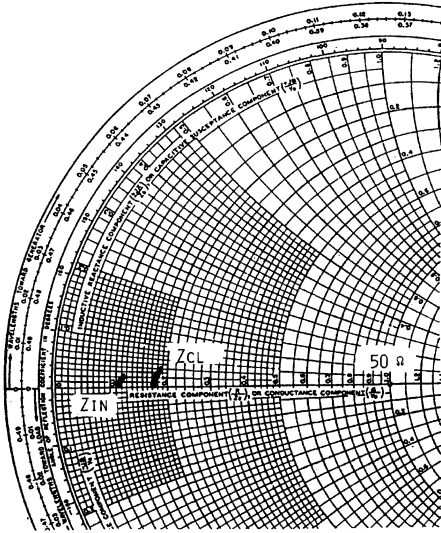
## TYPICAL PERFORMANCE

BROADBAND POWER GAIN vs  
FREQUENCY

## POWER OUTPUT vs POWER INPUT

COLLECTOR EFFICIENCY vs  
FREQUENCYINTERMODULATION DISTORTION vs  
POWER OUTPUTTHERMAL RESISTANCE vs CASE  
TEMPERATURE

## IMPEDANCE DATA



FREQ.	$Z_{IN} (\Omega)^*$	$Z_{CL} (\Omega)^{**}$
830 MHz	$5.6 + j 0.55$	$9.4 + j 2.1$
870 MHz	$5.8 + j 0.6$	$9.2 + j 1.1$
910 MHz	$5.9 + j 0.95$	$9.1 + j 0.0$

\* Base to Base

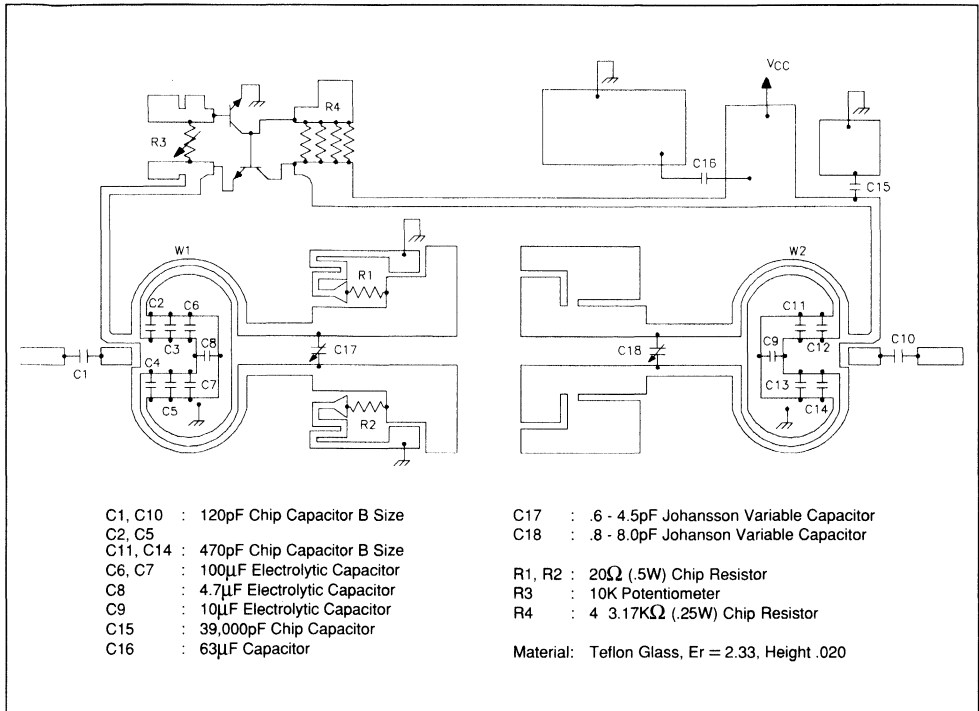
\*\* Collector to Collector

$P_{OUT} = 40W$

$V_{CC} = 24V$

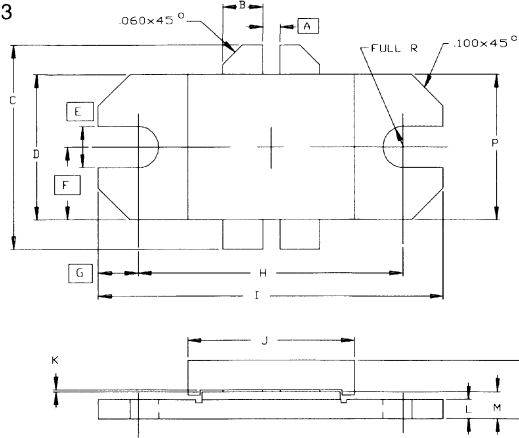


## TEST CIRCUIT



PACKAGE MECHANICAL DATA

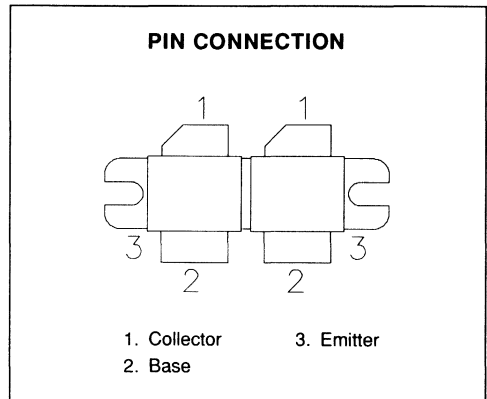
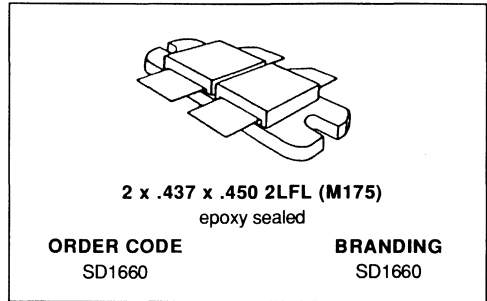
Ref.: Dwg. No.12-0173



SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.055/1,40		K	.002/0,05	.006/0,15
B	.120/3,05	.130/3,30	L	.055/1,40	.065/1,65
C		.785/19,94	M	.080/2,03	.095/2,41
D	.455/11,56	465/11,81	N		.195/4,95
E	.125/3,18		P	.455/11,56	.465/11,81
F	.230/5,84				
G	.128/3,25				
H	.838/21,28	850/21,59			
I	1.095/27,81	1.105/28,07			
J	.525/13,34	.535/13,59			

**RF & MICROWAVE TRANSISTORS**  
**800/900 MHz APPLICATIONS**

- 860 - 900 MHz
- 24 VOLTS
- CLASS AB PUSH PULL
- INTERNAL INPUT MATCHING
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- GOLD METALLIZATION FOR HIGH RELIABILITY
- DIFFUSED EMITTER BALLAST RESISTORS
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = 120 \text{ W MIN. WITH } 6.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1660 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in cellular base station applications.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_c$	Device Current	25	A
$P_{DISS}$	Power Dissipation	310	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 55 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.55	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

# SD1660

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>c</sub> = 100mA	I <sub>E</sub> = 0mA	60	—	—	V
BV <sub>CEO</sub>	I <sub>c</sub> = 100mA	I <sub>B</sub> = 0mA	30	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 50mA	I <sub>c</sub> = 0mA	3.0	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 28V	I <sub>E</sub> = 0mA	—	—	10	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>c</sub> = 3A	15	—	70	—

Tested Per Side

### DYNAMIC

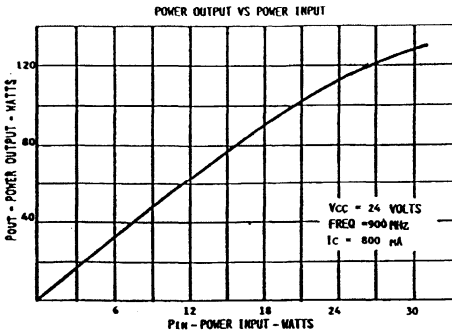
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub> *	f = 900 MHz	V <sub>CE</sub> = 24 V	I <sub>cQ</sub> = 2 x 400mA	120	—	—	W
G <sub>P</sub> *	f = 900 MHz	V <sub>CE</sub> = 24 V	I <sub>cQ</sub> = 2 x 400mA	6.0	—	—	dB
IMD**	f = 900 MHz	V <sub>CE</sub> = 24 V	I <sub>cQ</sub> = 2 x 400mA	—	-32	—	dBc
η <sub>c</sub>	f = 900 MHz	V <sub>CE</sub> = 24 V	I <sub>cQ</sub> = 2 x 400mA	50	—	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	100	pF

Note: \* @ 1 dB Compression

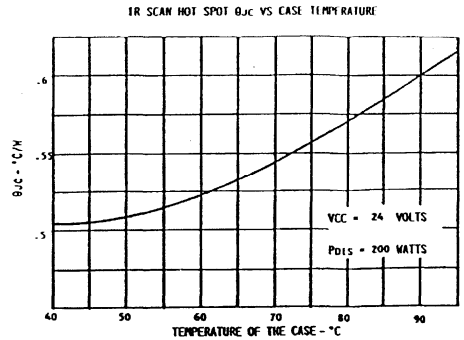
\*\* P<sub>OUT</sub> = 120W PEP, Δ F = 600KHz (2 tones)

### TYPICAL PERFORMANCE

#### POWER OUTPUT vs POWER INPUT

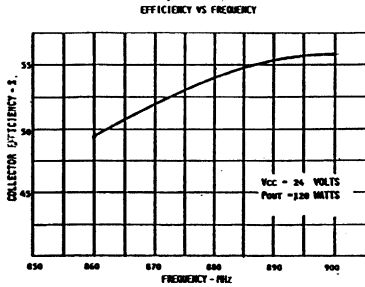


#### THERMAL RESISTANCE vs CASE TEMPERATURE

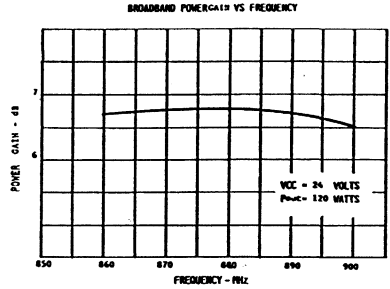


TYPICAL PERFORMANCE (cont'd)

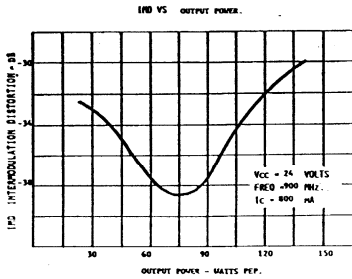
COLLECTOR EFFICIENCY vs FREQUENCY



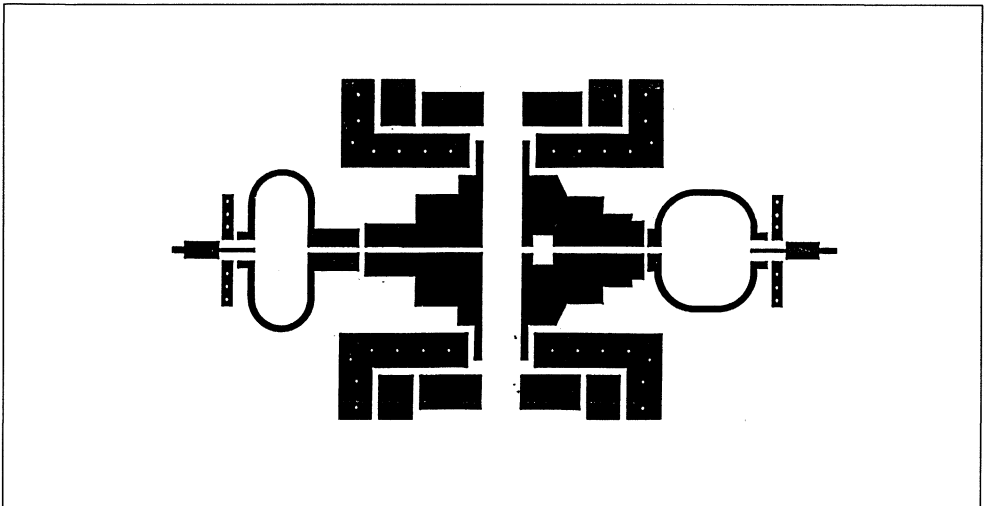
BROADBAND POWER GAIN vs FREQUENCY



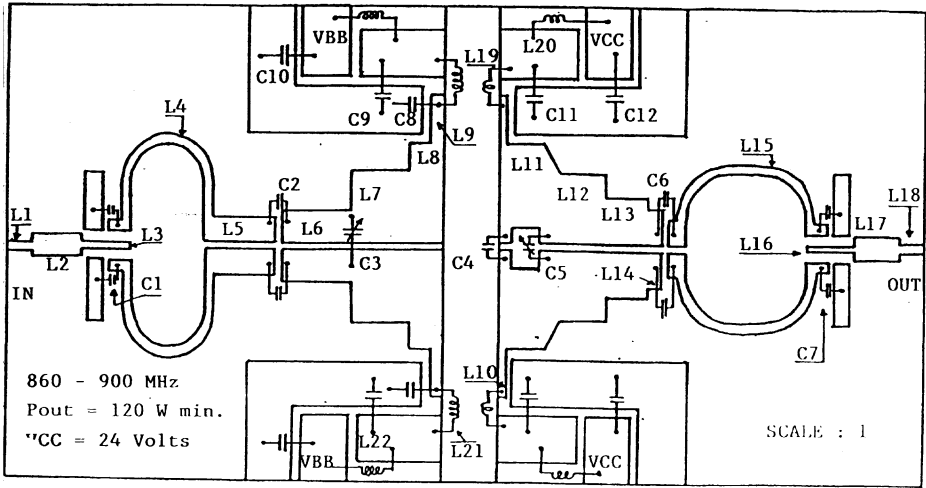
INTERMODULATION DISTORTION vs POWER OUTPUT



PHOTOMASTER OF TEST CIRCUIT



## TEST CIRCUIT



B1, B2 : Coaxial Cable 25.43mm

C1, C2 : 330pF, ATC 100B

C3 : .8 - 8.0pF Johanson Gigatrim

C4 : 4.7 + 3.9pF, ATC 100B

C5 : 3.9 + 1.7pF, ATC 100B + .8 - 8.0pF  
 Johanson Gigatrim

C6, C7 : 330pF, ATC 100B

C8 : 120pF ATC 100B

C9 : 1.5nF, ATC 100B

C10 : 10nF + 47 $\mu$ F, 63V

C11 : 1.5nF, ATC 100B + 10nF

C12 : 470pF + 1.5nF, ATC 100B + 100mF, 63V

Substrate: Teflon Glass, Er = 2.55, 30Mils Thick

L1, L18 : Printed Line 50 $\Omega$

L2, L17 : Printed Line 26.7 $\Omega$  10mm

L3, L16 : Printed Line 60 $\Omega$  10.5mm

L4, L15 : Printed Line 50 $\Omega$  43mm

L5 : Printed Line 25 $\Omega$  13.5mm

L6 : Printed Line 21 $\Omega$  15mm

L7 : Printed Line 10.5 $\Omega$  12.5mm

L8 : Printed Line 8 $\Omega$  7.5mm

L9, L10 : Printed Line 50 $\Omega$  10mm

L11 : Printed Line 9.5 $\Omega$  10.5mm

L12 : Printed Line 11 $\Omega$  14.5mm

L13 : Printed Line 15.5 $\Omega$  8.5mm

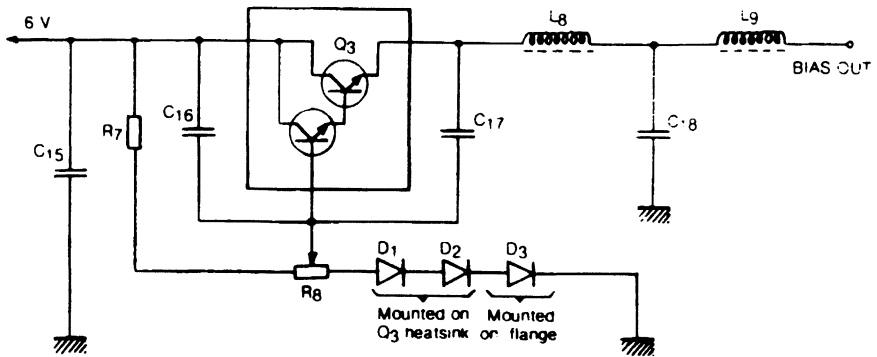
L14 : Printed Line 19 $\Omega$  3.5mm

L19 : 2 Turns, #16 AWG

L20 : 2 Turns, #16 AWG

L21, L22 : 12 Turns, #22 AWG

## BIAS VOLTAGE SOURCE



C15 : 10nF + 100nF + 10 $\mu$ F  
 C16 : 10nF  
 C17 : 1 $\mu$ F  
 C18 : 1.2nF + 27nF + 10 $\mu$ F

D1 : AAY 49, Ge Diode Thermally Connected with Q3 Heatsink  
 D2 : 1N 4005, Si Diode Thermally Connected with Q3 Heatsink  
 D3 : 1N 4005, Si Diode Thermally Connected with RF Transistors Flange

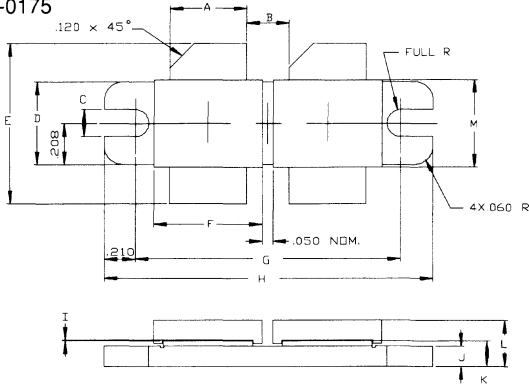
L8, L9 : Ferrite Choke

Q3 : BDX 63B

R7 : 470 $\Omega$ , 1/2W  
 R8 : 100 $\Omega$ , Trimpot

PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0175

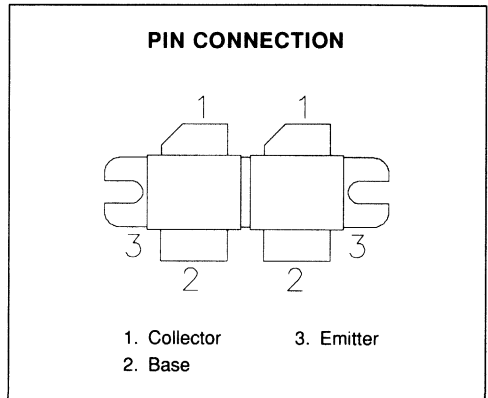
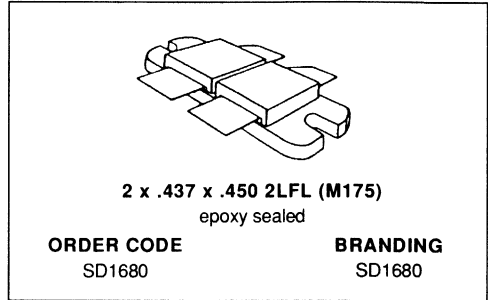


SGS-THOMSON MICROELECTRONICS		COND			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.373/9,47	.385/9,78	K	.115/2,92	.135/3,43
B	.190/4,83		L		.250/6,35
C	.125/3,18		M	.445/11,30	.455/11,56
D	.411/10,44	.421/10,69			
E	.825/20,96	.865/21,97			
F	.525/13,34	.535/13,59			
G	1.255/31,88	1.265/32,13			
H	1.675/42,55	1.685/42,80			
I	.002/0,05	.006/0,15			
J	.095/2,41	.105/2,67			



**RF & MICROWAVE TRANSISTORS**  
**800/900 MHz APPLICATIONS**

- 915 - 960 MHz
- 24 VOLTS
- CLASS AB PUSH PULL
- INTERNAL INPUT MATCHING
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- GOLD METALLIZATION FOR HIGH RELIABILITY
- DIFFUSED EMITTER BALLAST RESISTORS
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = 100 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1680 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in cellular base station applications.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_c$	Device Current	25	A
$P_{DISS}$	Power Dissipation	310	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 55 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.55	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 100mA	I <sub>E</sub> = 0mA	60	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 100mA	I <sub>B</sub> = 0mA	30	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 50mA	I <sub>C</sub> = 0mA	3.0	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 28V	I <sub>E</sub> = 0mA	—	—	10	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 3A	15	—	70	—

Tested Per Side

DYNAMIC

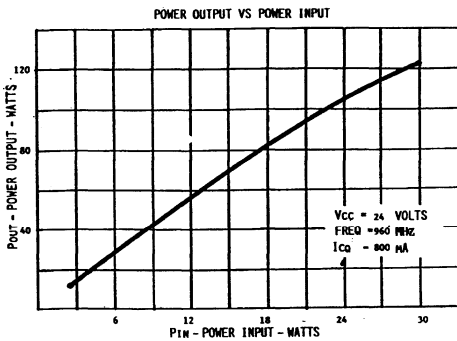
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub> *	f = 900 MHz	V <sub>CE</sub> = 24 V	I <sub>CQ</sub> = 2 x 300 mA	120	—	—	W
G <sub>P</sub> *	f = 900 MHz	V <sub>CE</sub> = 24 V	I <sub>CQ</sub> = 2 x 300 mA	7.0	—	—	dB
IMD**	f = 900 MHz	V <sub>CE</sub> = 24 V	I <sub>CQ</sub> = 2 x 300 mA	—	-32	—	dBc
η <sub>C</sub>	f = 900 MHz	V <sub>CE</sub> = 24 V	I <sub>CQ</sub> = 2 x 300 mA	45	—	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	—	100	pF

Note: \* @ 1 dB Compression

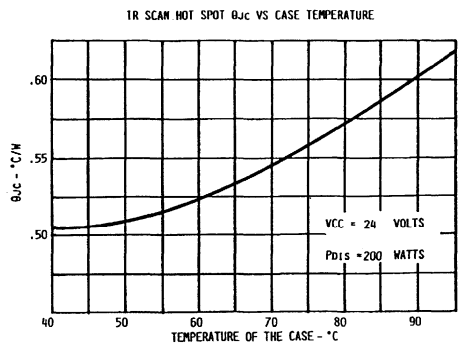
\*\* P<sub>OUT</sub> = 100W PEP, Δ F = 400KHz (2 tones)

TYPICAL PERFORMANCE

POWER OUTPUT vs POWER INPUT

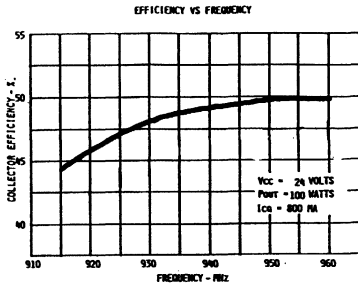


THERMAL RESISTANCE vs CASE TEMPERATURE

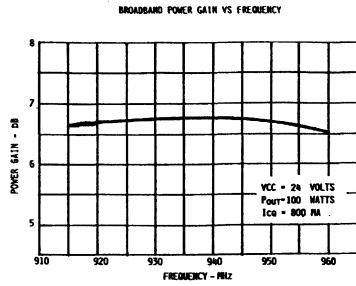


## TYPICAL PERFORMANCE (cont'd)

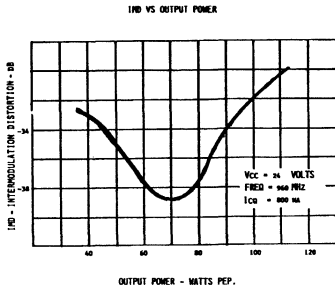
## COLLECTOR EFFICIENCY vs FREQUENCY



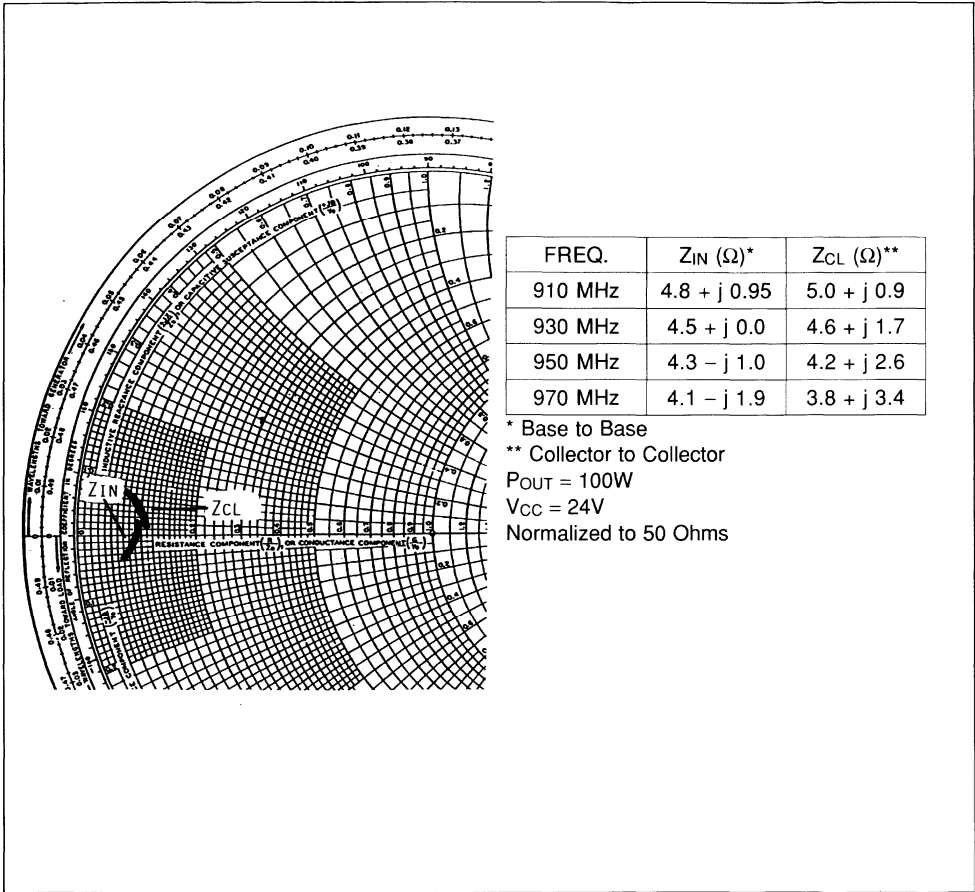
## BROADBAND POWER GAIN vs FREQUENCY



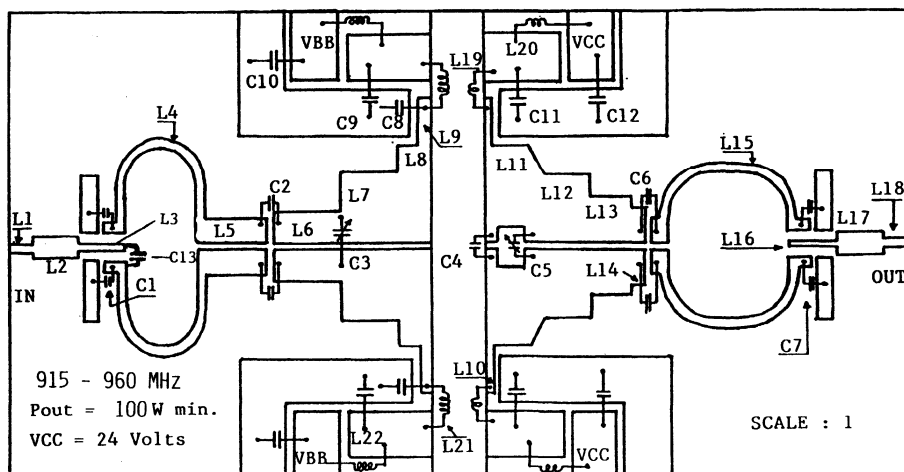
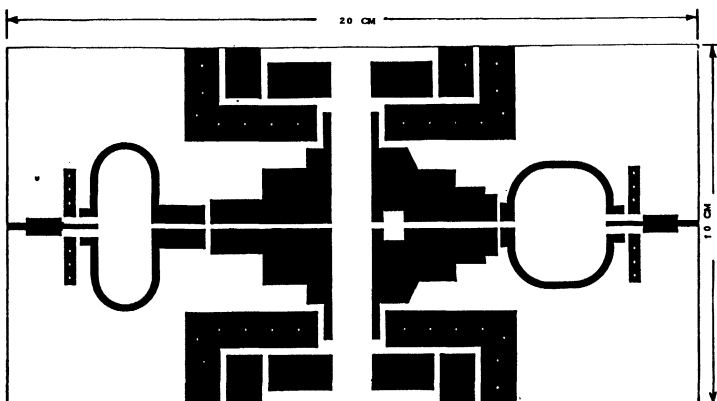
## INTERMODULATION DISTORTION vs POWER OUTPUT



IMPEDANCE DATA



## TEST CIRCUIT



B1, B2 : Coaxial Cable 25, 43mm

C1, C2 : 330pF, ATC 100B

C3 : .8 - 8.0pF Johanson Gigatrim

C4 : 2 x 3.6pF + 1.6pF ATC 100B

C5 : 3.3pF ATC 100B + .8 - 8.0pF  
 Johanson Gigatrim

C6, C7 : 330pF, ATC 100B

C8 : 120pF ATC 100B

C9 : 1.5nF, ATC 100B

C10 : 10nF + 47 $\mu$ F, 63V

C11 : 1.5nF, ATC 100B + 10nF

C12 : 470pF + 1.5nF, ATC 100B + 100mF, 63V

C13 : .4 - 4pF Johanson Gigatrim

L1, L18 : Printed Line 50 $\Omega$

L2, L17 : Printed Line 26.7 $\Omega$  10mm

L3, L16 : Printed Line 60 $\Omega$  10.5mm

L4, L15 : Printed Line 50 $\Omega$  43mm

L5 : Printed Line 25 $\Omega$  13.5mm

L6 : Printed Line 21 $\Omega$  15mm

L7 : Printed Line 10.5 $\Omega$  12.5mm

L8 : Printed Line 8 $\Omega$  7.5mm

L9, L10 : Printed Line 50 $\Omega$  10mm

L11 : Printed Line 9.5 $\Omega$  10.5mm

L12 : Printed Line 11 $\Omega$  14.5mm

L13 : Printed Line 15.5 $\Omega$  8.5mm

L14 : Printed Line 19 $\Omega$  3.5mm

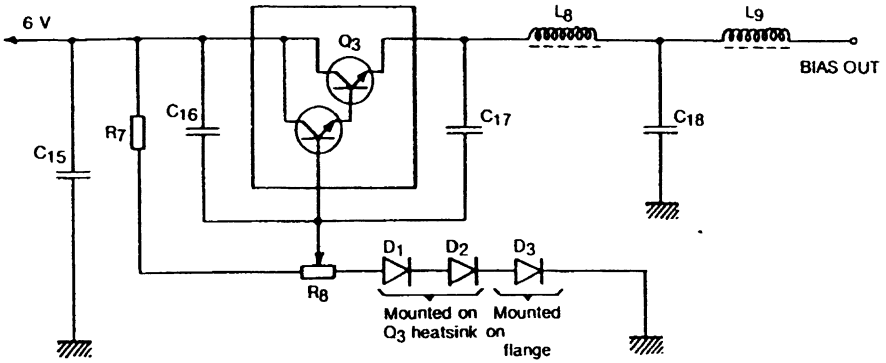
L19 : 2 Turns, #16 AWG

L20 : 2 Turns, #16 AWG

L21, L22 : 12 Turns, #22 AWG

Substrate: Teflon Glass, Er = 2.55, 30Mils Thick

## BIAS VOLTAGE SOURCE



C15 : 10nF + 100nF + 10 $\mu$ F  
 C16 : 10nF  
 C17 : 1 $\mu$ F  
 C18 : 1.2nF + 27nF + 10 $\mu$ F

D1 : AAY 49, Ge Diode Thermally Connected with Q3 Heatsink  
 D2 : 1N 4005, SI Diode Thermally Connected with Q3 Heatsink  
 D3 : 1N 4005, SI Diode Thermally Connected with RF Transistors Flange

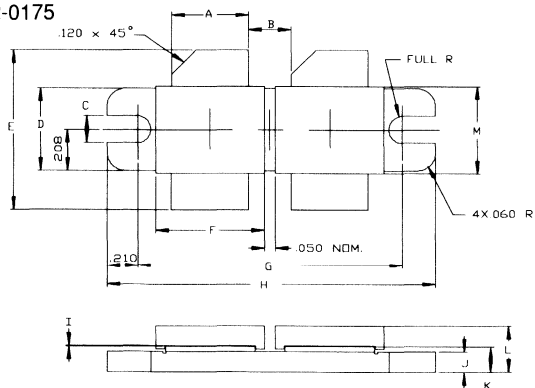
L8, L9 : Ferrite Choke

Q3 : BDX 63B

R7 : 470 $\Omega$ , 1/2W  
 R8 : 100 $\Omega$ , Trimpot

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0175



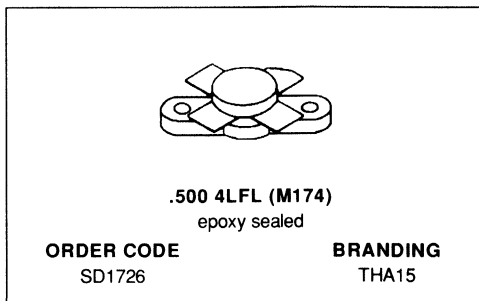
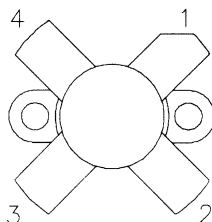
SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.373/9,47	.385/9,78	K	.115/2,92	.135/3,43
B	.190/4,83		L	.250/6,35	
C	.125/3,18		M	.445/11,30	.455/11,56
D	.411/10,44	.421/10,69			
E	.825/20,96	.865/21,97			
F	.525/13,34	.535/13,59			
G	1.255/31,88	1.265/32,13			
H	1.675/42,55	1.685/42,80			
I	.002/0,05	.006/0,15			
J	.095/2,41	.105/2,67			





**RF & MICROWAVE TRANSISTORS  
 HF SSB APPLICATIONS**

- OPTIMIZED FOR SSB
- 30 MHz
- 50 VOLTS
- IMD -30 dB
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 150$  W PEP MIN. WITH 14 dB GAIN


**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Base    |
| 2. Emitter   | 4. Emitter |

**DESCRIPTION**

The SD1726 is a 50 V epitaxial silicon NPN planar transistor designed primarily for SSB communications. This device utilizes emitter ballasting to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	110	V
$V_{CEO}$	Collector-Emitter Voltage	55	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	10	A
$P_{DISS}$	Power Dissipation	233	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.75	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

## SD1726 (THA15)

### ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

#### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CB0</sub>	I <sub>C</sub> = 100mA	I <sub>E</sub> = 0mA	110	—	—	V
BV <sub>CES</sub>	I <sub>C</sub> = 100mA	V <sub>BE</sub> = 0V	110	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 100mA	I <sub>B</sub> = 0mA	55	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 10mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CEO</sub>	V <sub>CE</sub> = 30V	I <sub>E</sub> = 0mA	—	—	5	mA
I <sub>CES</sub>	V <sub>CE</sub> = 60V	I <sub>E</sub> = 0mA	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 6V	I <sub>C</sub> = 1.4A	18	—	43.5	—

#### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 30 MHz	V <sub>CE</sub> = 50 V	I <sub>CQ</sub> = 100mA	150	—	—	W
G <sub>P</sub> *	P <sub>OUT</sub> = 150 WPEP	V <sub>CE</sub> = 50 V	I <sub>CQ</sub> = 100mA	14	—	—	dB
IMD*	P <sub>OUT</sub> = 150 WPEP	V <sub>CE</sub> = 50 V	I <sub>CQ</sub> = 100mA	—	—	-30	dBc
η <sub>C</sub> *	P <sub>OUT</sub> = 150 WPEP	V <sub>CE</sub> = 50 V	I <sub>CQ</sub> = 100mA	37	—	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 50 V		—	—	220	pF

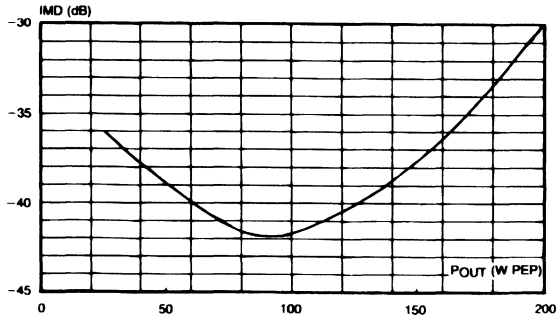
Note: The SD1726 is also usable in Class A at 40 V. Typical performance is:

P<sub>OUT</sub> = 30 W PEP, G<sub>P</sub> = 14 dB, IMD = -40dBc

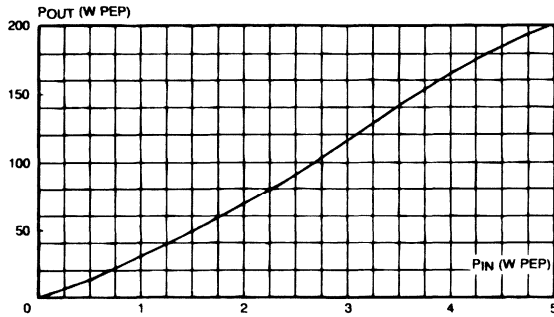
\* f<sub>1</sub> = 30.00 MHz; f<sub>2</sub> = 30.001 MHz

## TYPICAL PERFORMANCE

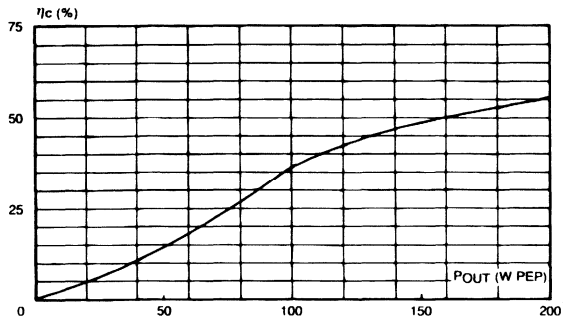
INTERMODULATION DISTORTION vs POWER OUTPUT PEP



POWER OUTPUT PEP vs POWER INPUT

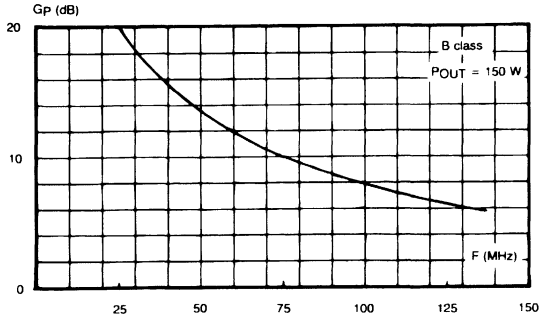


COLLECTOR EFFICIENCY vs POWER OUTPUT PEP

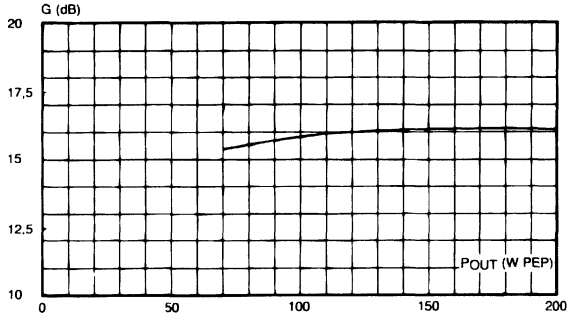


TYPICAL PERFORMANCE (cont'd)

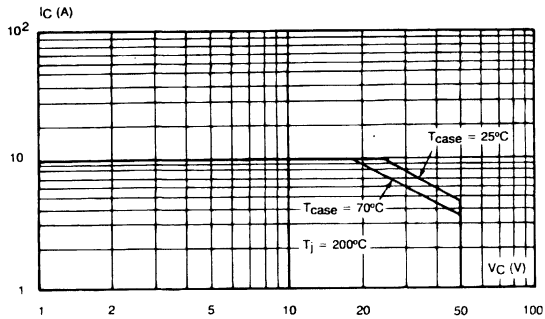
POWER GAIN vs FREQUENCY



POWER GAIN vs POWER OUTPUT PEP

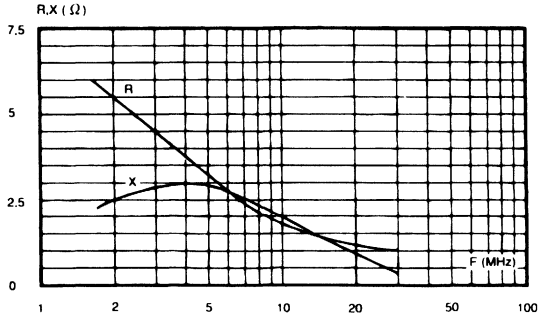


SAFE OPERATING AREA

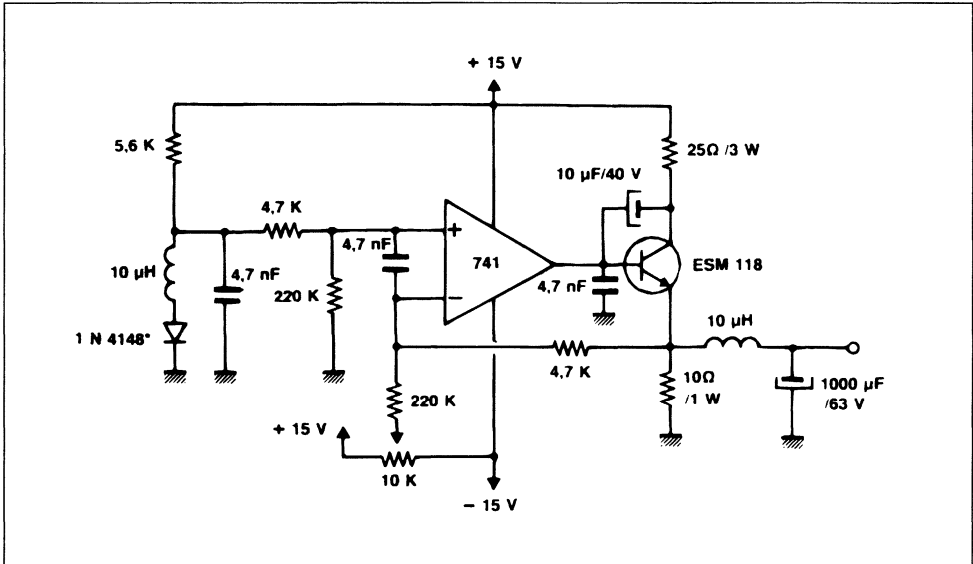


## IMPEDANCE DATA

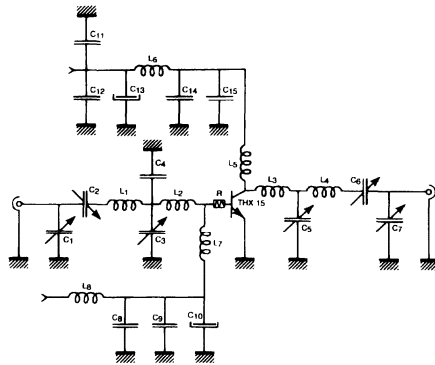
## TYPICAL INPUT IMPEDANCE



## BIAS CIRCUIT

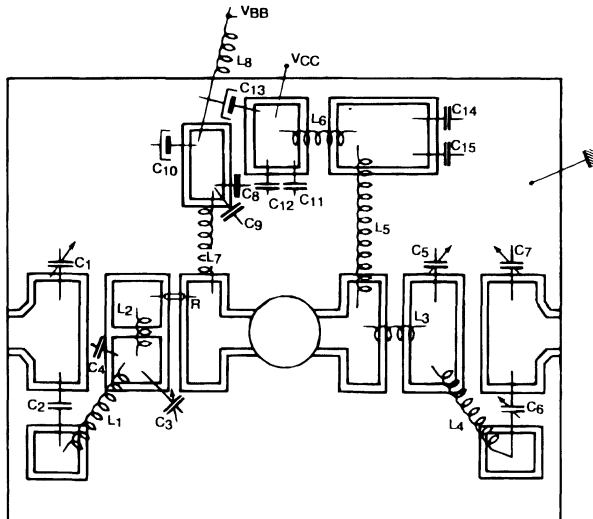


TEST CIRCUIT - CLASS AB - 30 MHz



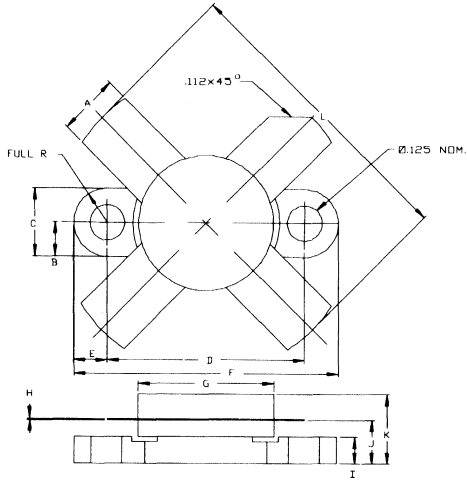
- |         |             |        |   |
|---------|-------------|--------|---|
| C1      | : Arco 427  | L1     | : 5 Turns Diameter 8mm, 1.3mm Wire, Length 15mm |
| C2      | : Arco 4611 | L2     | : Hair Pin Copper Foil 20 x 5mm, 0.2mm Thick    |
| C3      | : Arco 4615 | L3     | : 1 Turn Diameter 10mm, 1.3mm Wire, Length 8mm  |
| C4      | : 220pF     | L4     | : 6 Turns Diameter 8mm, 1.3mm Wire, Length 25mm |
| C5, C6  | : Arco 4215 | L5     | : 4 Turns Diameter 12mm, 2mm Wire, Length 25mm  |
| C7      | : Arco 426  | L6, L7 | : Choke   |
| C8, C12 | : 100nF 63V | R      | : 0.6Ω  |
| C9, C11 | : 1nF       |        |   |
| C10     | : 470μF 40V |        |   |
| C13     | : 220μF 63V |        |   |
| C14     | : 10nF      |        |   |

MOUNTING CIRCUIT - CLASS AB - 30MHz



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0174



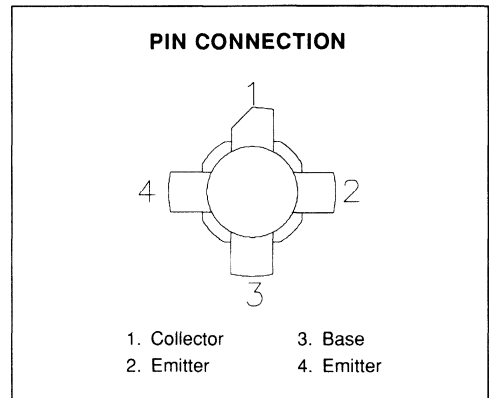
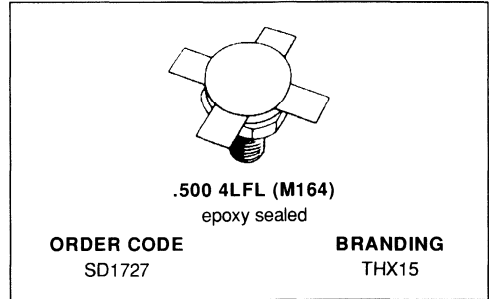
SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K		.280/7,11
B	.125/3,18		L		1.050/26,67
C	.245/6,22	.255/6,48			
D	.720/18,28	.730/18,54			
E	.125/3,18				
F	.970/24,64	.980/24,89			
G	.495/12,57	.505/12,83			
H	.003/0,08	.007/0,18			
I	.090/2,29	.110/2,79			
J	.160/4,06	.175/4,45			





**RF & MICROWAVE TRANSISTORS  
 HF SSB APPLICATIONS**

- OPTIMIZED FOR SSB
- 30 MHz
- 50 VOLTS
- IMD -30 dB
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 150$  W PEP MIN. WITH 14 dB GAIN


**DESCRIPTION**

The SD1727 is a 50 V epitaxial silicon NPN planar transistor designed primarily for SSB communications. This device utilizes emitter ballasting to achieve extreme ruggedness under severe operating conditions.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	110	V
$V_{CEO}$	Collector-Emitter Voltage	55	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	10	A
$P_{DISS}$	Power Dissipation	233	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.75	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

## SD1727 (THX15)

### ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

#### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{E}} = 0\text{mA}$	110	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 100\text{mA}$	$V_{\text{BE}} = 0\text{V}$	110	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 100\text{mA}$	$I_{\text{B}} = 0\text{mA}$	55	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$I_{\text{CEO}}$	$V_{\text{CE}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	5	mA
$I_{\text{CES}}$	$V_{\text{CE}} = 60\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 6\text{V}$	$I_{\text{C}} = 1.4\text{A}$	18	—	43.5	—

#### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 30\text{ MHz}$	$V_{\text{CE}} = 50\text{ V}$	$I_{\text{CQ}} = 100\text{mA}$	150	—	—	W
$G_{\text{P}}^*$	$P_{\text{OUT}} = 150\text{ WPEP}$	$V_{\text{CE}} = 50\text{ V}$	$I_{\text{CQ}} = 100\text{mA}$	14	—	—	dB
$\text{IMD}^*$	$P_{\text{OUT}} = 150\text{ WPEP}$	$V_{\text{CE}} = 50\text{ V}$	$I_{\text{CQ}} = 100\text{mA}$	—	—	-30	dBc
$\eta_{\text{c}}^*$	$P_{\text{OUT}} = 150\text{ WPEP}$	$V_{\text{CE}} = 50\text{ V}$	$I_{\text{CQ}} = 100\text{mA}$	37	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 50\text{ V}$		—	—	220	pF

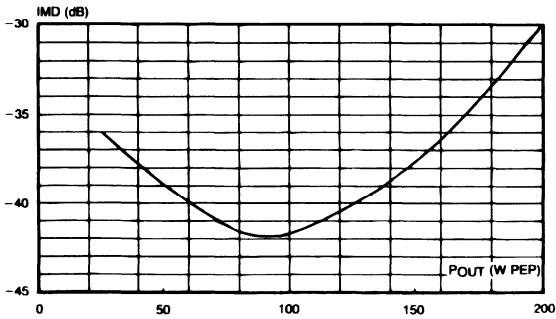
Note: The SD1727 is also usable in Class A at 40 V. Typical performance is:

$P_{\text{OUT}} = 30\text{ W PEP}$ ,  $G_{\text{P}} = 14\text{ dB}$ ,  $\text{IMD} = -40\text{ dBc}$

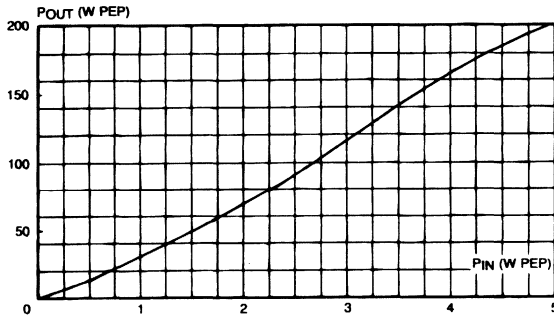
\*  $f_1 = 30.00\text{ MHz}$ ;  $f_2 = 30.001\text{ MHz}$

## TYPICAL PERFORMANCE

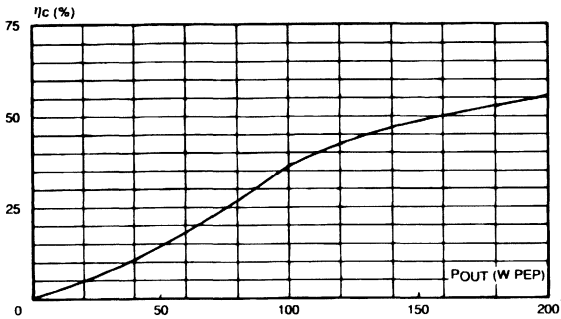
INTERMODULATION DISTORTION vs POWER OUTPUT PEP



POWER OUTPUT PEP vs POWER INPUT

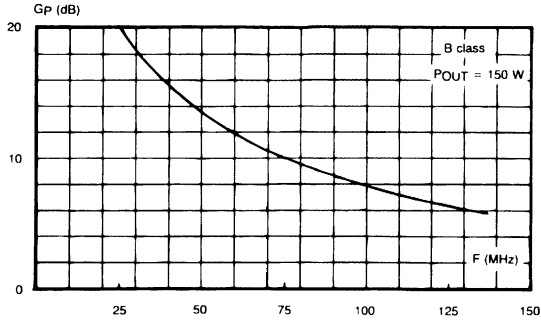


COLLECTOR EFFICIENCY vs POWER OUTPUT PEP

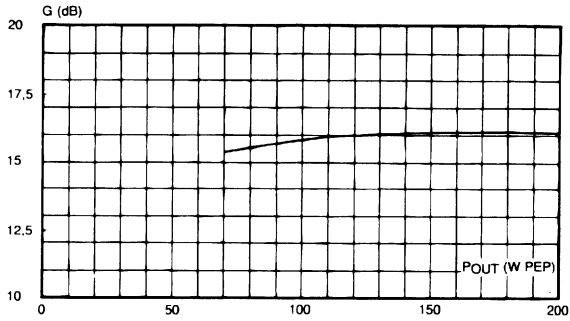


TYPICAL PERFORMANCE (cont'd)

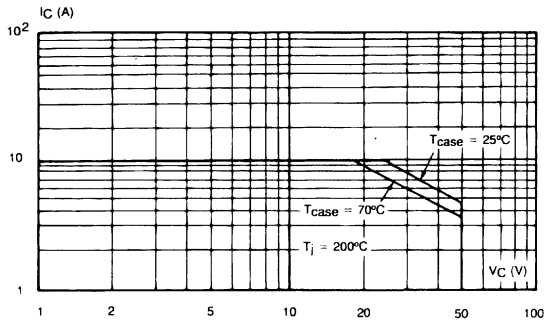
POWER GAIN vs FREQUENCY



POWER GAIN vs POWER OUTPUT PEP

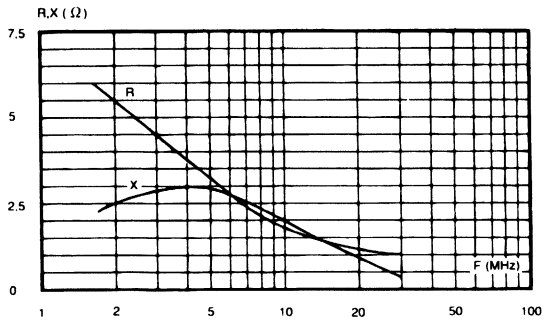


SAFE OPERATING AREA

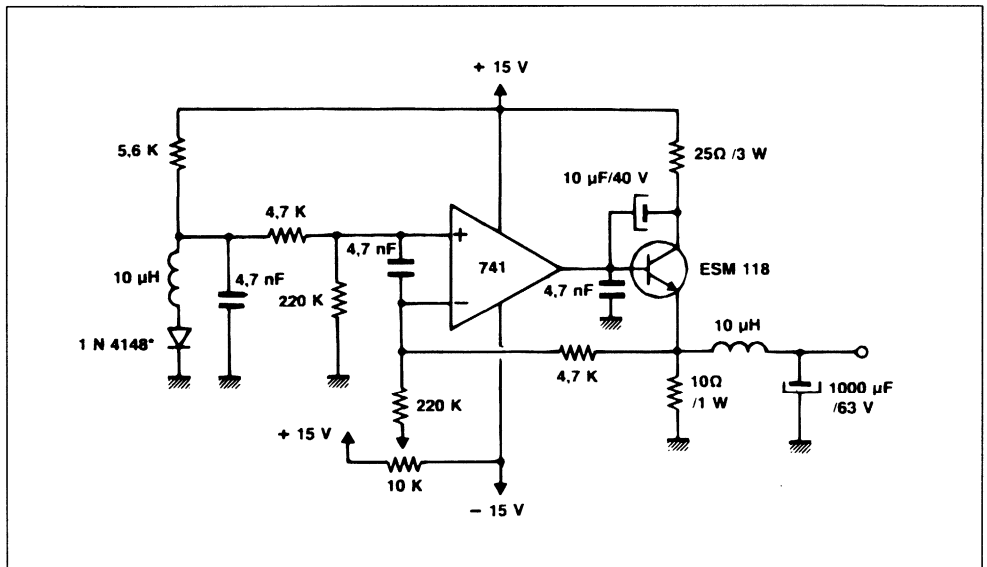


## IMPEDANCE DATA

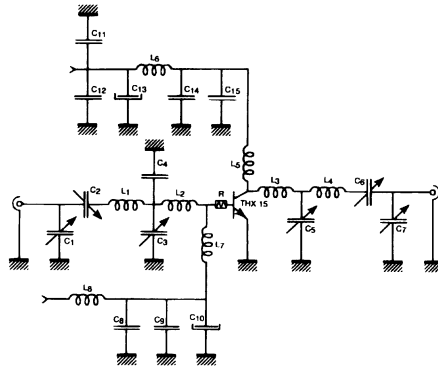
## TYPICAL INPUT IMPEDANCE



## BIAS CIRCUIT

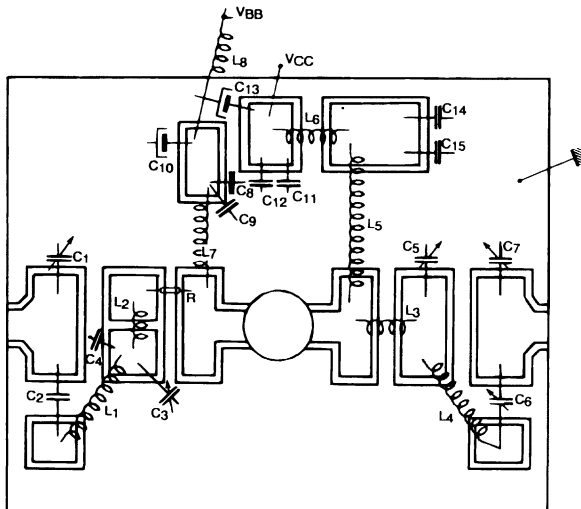


TEST CIRCUIT - CLASS AB - 30 MHz



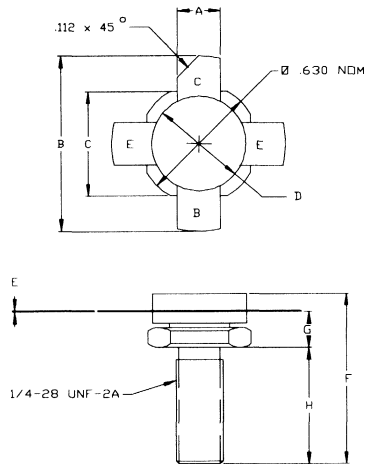
- |         |             |        |   |
|---------|-------------|--------|---|
| C1      | : Arco 427  | L1     | : 5 Turns Diameter 8mm, 1.3mm Wire, Length 15mm |
| C2      | : Arco 4611 | L2     | : Hair Pin Copper Foil 20 x 5mm, 0.2mm Thick    |
| C3      | : Arco 4615 | L3     | : 1 Turn Diameter 10mm, 1.3mm Wire, Length 8mm  |
| C4      | : 220pF     | L4     | : 6 Turns Diameter 8mm, 1.3mm Wire, Length 25mm |
| C5, C6  | : Arco 4215 | L5     | : 4 Turns Diameter 12mm, 2mm Wire, Length 25mm  |
| C7      | : Arco 426  | L6, L7 |   |
| C8, C12 | : 100nF 63V | L8     | : Choke   |
| C9, C11 |             | R      | : 0.6Ω  |
| C15     | : 1nF       |        |   |
| C10     | : 470μF 40V |        |   |
| C13     | : 220μF 63V |        |   |
| C14     | : 10nF      |        |   |

MOUNTING CIRCUIT - CLASS AB - 30MHz



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0164



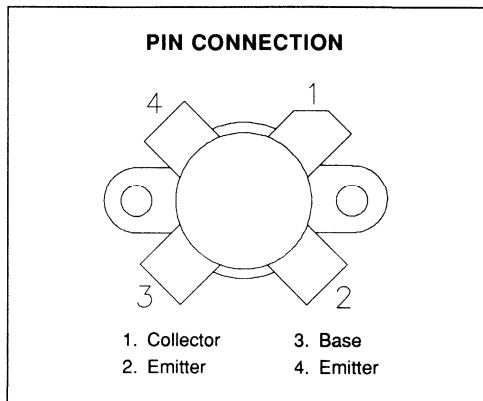
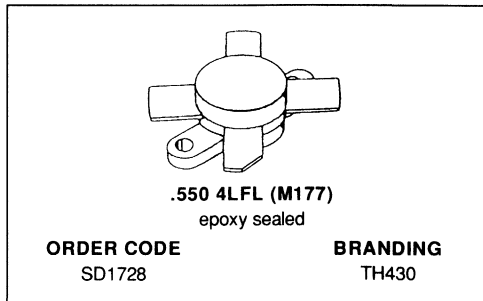
SGS - THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	1.050/26,67	
C	.545/13,84	.555/14,10
D	.495/12,57	.505/12,83
E	.003/0,08	.007/0,18
F		.830/21,08
G	.185/4,70	.198/5,03
H	.497/12,62	.530/13,46





## RF & MICROWAVE TRANSISTORS HF SSB APPLICATIONS

- OPTIMIZED FOR SSB
- 30 MHz
- 50 VOLTS
- IMD – 30 dB
- GOLD METALLIZATION
- COMMON EMITTER
- $P_{OUT} = 250 \text{ W PEP WITH } 14.5 \text{ dB GAIN}$



### DESCRIPTION

The SD1728 is a 50 V epitaxial silicon NPN planar transistor designed primarily for SSB and VHF communications. This device utilizes emitter ballasting for improved ruggedness and reliability.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	110	V
$V_{CEO}$	Collector-Emitter Voltage	55	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	40	A
$P_{DISS}$	Power Dissipation	330	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	– 65 to +150	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.4	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

## SD1728 (TH430)

### ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

#### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CES}$	$I_C = 200mA$	$V_{BE} = 0V$	110	—	—	V
$BV_{CEO}$	$I_C = 200mA$	$I_B = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CEO}$	$V_{CE} = 30V$	$I_E = 0mA$	—	—	10	mA
$I_{CES}$	$V_{CE} = 60V$	$I_E = 0mA$	—	—	10	mA
$h_{FE}$	$V_{CE} = 6V$	$I_C = 10A$	15	—	45	—

#### DYNAMIC

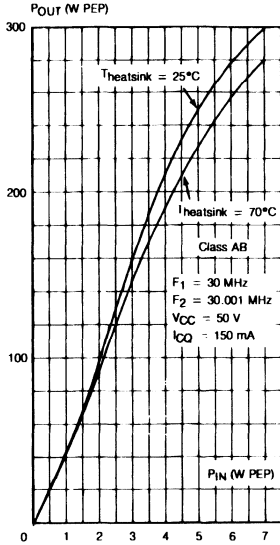
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 30\text{ MHz}$	$V_{CC} = 50\text{ V}$	$I_{CQ} = 150\text{ mA}$	250	—	—	W
$G_P^*$	$P_{OUT} = 250\text{ W PEP}$	$V_{CC} = 50\text{ V}$	$I_{CQ} = 150\text{ mA}$	14.5	—	—	dB
IMD*	$P_{OUT} = 250\text{ W PEP}$	$V_{CC} = 50\text{ V}$	$I_{CQ} = 150\text{ mA}$	—	—	-30	dBc
$\eta_C^*$	$P_{OUT} = 250\text{ W PEP}$	$V_{CC} = 50\text{ V}$	$I_{CQ} = 150\text{ mA}$	37	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 50\text{ V}$		—	—	360	pF

Note: \* Two Tone Method;  $f_1 = 30.00\text{ MHz}$ ;  $f_2 = 30.001\text{ MHz}$   
In Class C:  $G_P$  Min. 13.5 dB, Efficiency 65% @ 30MHz  
 $G_P$  Min. 10 dB, Efficiency 57% @ 70MHz

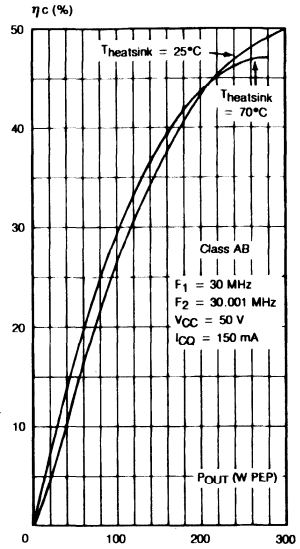
TYPICAL PERFORMANCE

CLASS AB

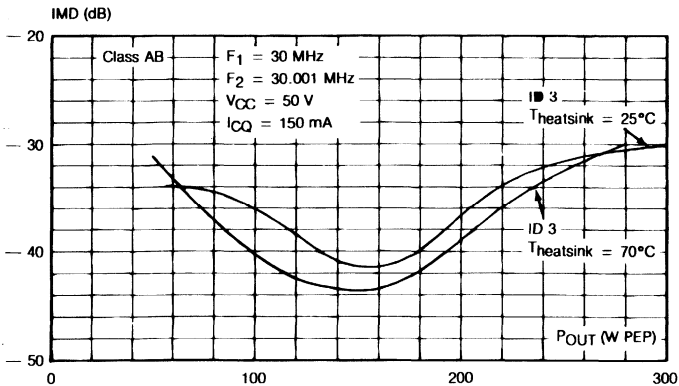
POWER OUTPUT PEP vs POWER INPUT



COLLECTOR EFFICIENCY vs POWER OUTPUT PEP

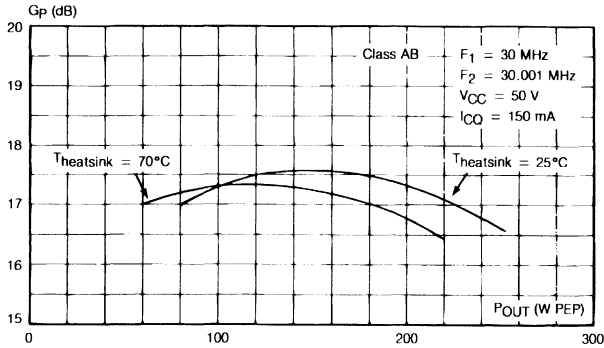


INTERMODULATION DISTORTION vs POWER OUTPUT PEP

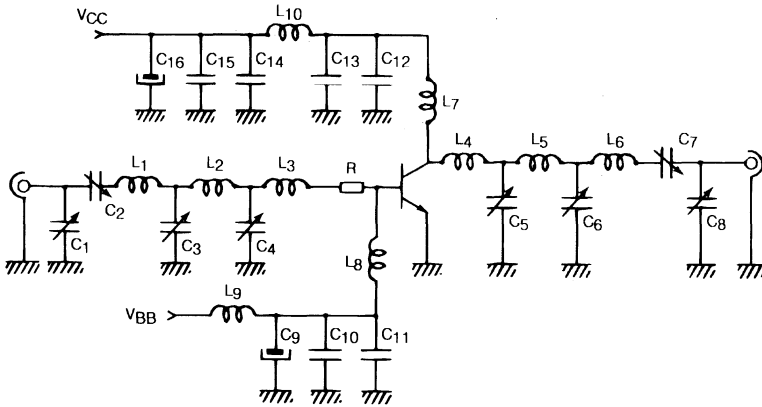


TYPICAL PERFORMANCE (cont'd)

POWER GAIN vs POWER OUTPUT PEP



TEST CIRCUIT SSB - CLASS AB - 30 MHz

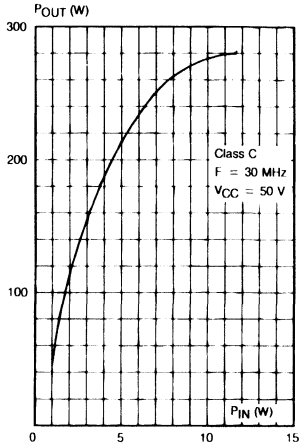


- |           |                    |    |   |
|-----------|--------------------|----|---|
| C1        | : Arco 429         | L1 | : 5 Turns, Diameter 10mm, 1.3mm Wire, Length 15mm |
| C2        | : Arco 4615        | L2 | : 2 Turns, Diameter 12mm, 2mm Wire, Length 8mm    |
| C3, C6    | : Arco 4213        | L3 | : 1 Turn, Diameter 12mm, 2mm Wire, Length 5mm     |
| C4, C5,   |                    | L4 | : Hair Pin Copper Foil 20 x 5mm                   |
| C7        | : Arco 4611        | L5 | : 1 Turn, Diameter 12mm, 2mm Wire, Length 8mm     |
| C8        | : Arco 427         | L6 | : 5 Turns, Diameter 8mm, 1.3mm Wire, Length 18mm  |
| C9        | : 470 $\mu$ F, 40V | L7 | : 3 Turns, Diameter 8mm, 1.3mm Wire, Length 15mm  |
| C10, C14  | : 100nF, 63V       | R  | : 0.25 $\Omega^*$                                 |
| C11, C13, |                    |    |   |
| C15       | : 1nF              |    |   |
| C12       | : 10nF             |    |   |
| C16       | : 220 $\mu$ F, 63V |    |   |
- \* 4 Resistors 1 $\Omega$  0.5W in parallel

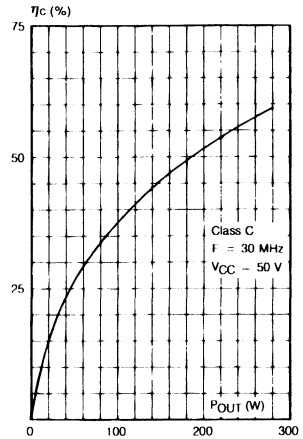
## TYPICAL PERFORMANCE

CLASS C  $F = 30 \text{ MHz}$ 

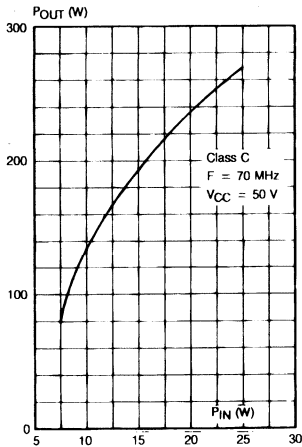
POWER OUTPUT vs POWER INPUT



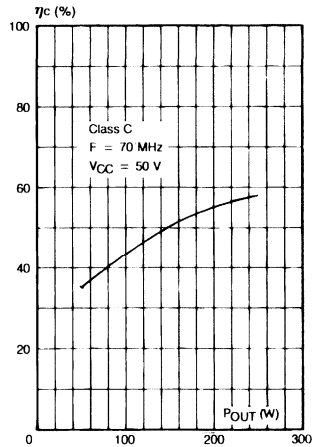
COLLECTOR EFFICIENCY vs POWER OUTPUT

CLASS C  $F = 70 \text{ MHz}$ 

POWER OUTPUT vs POWER INPUT

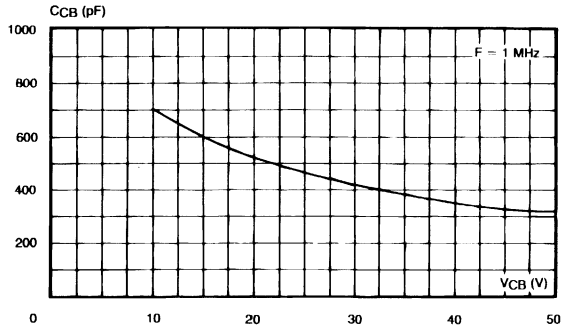


COLLECTOR EFFICIENCY vs POWER OUTPUT

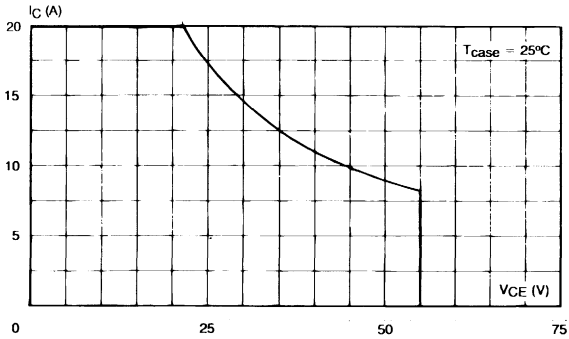


TYPICAL PERFORMANCE (cont'd)

COLLECTOR BASE CAPACITANCE vs COLLECTOR BASE VOLTAGE

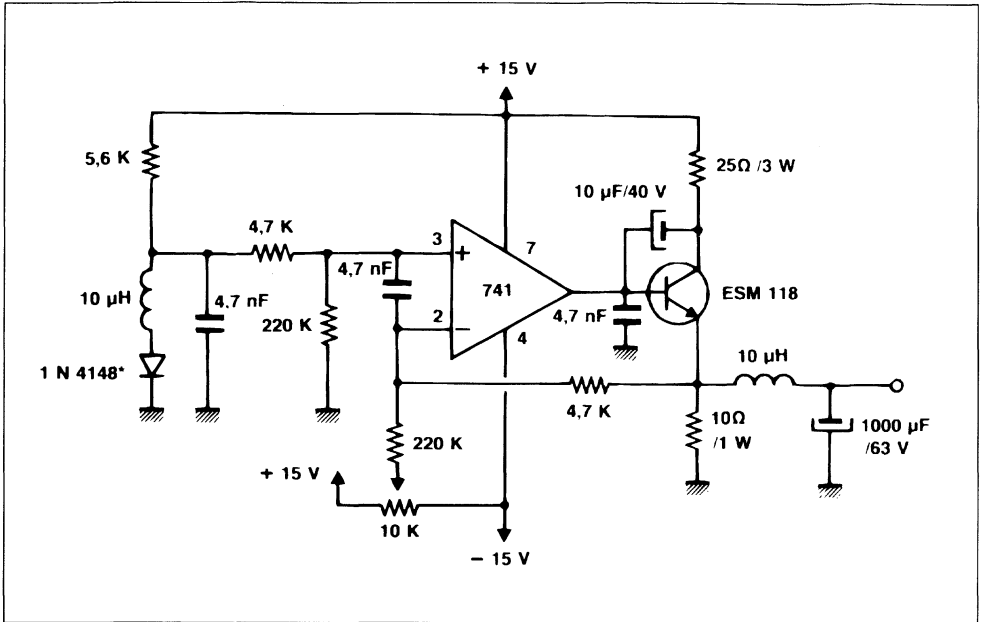


DC SAFE OPERATING AREA

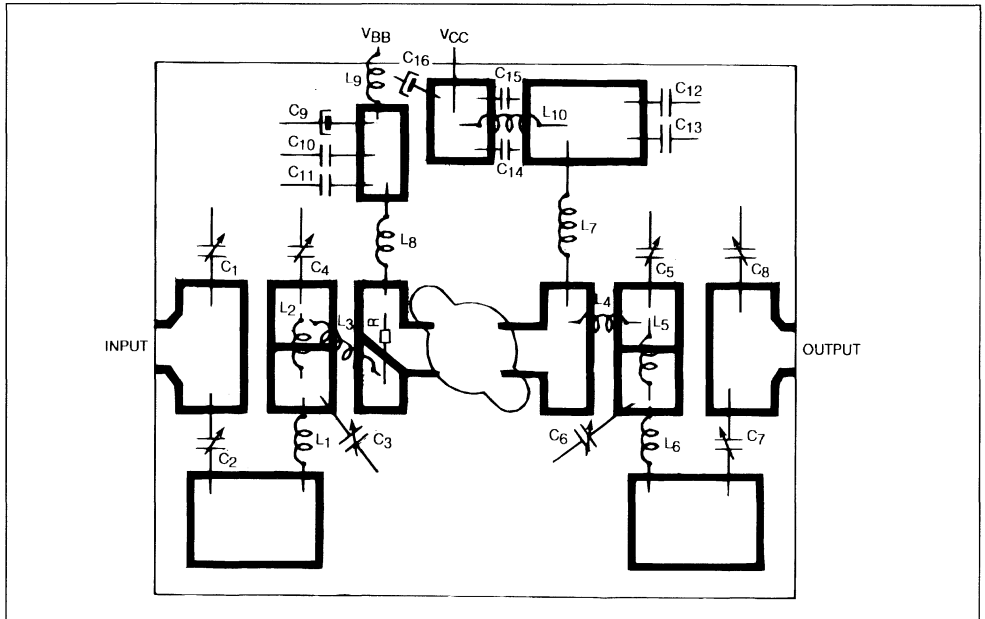




BIAS CIRCUIT



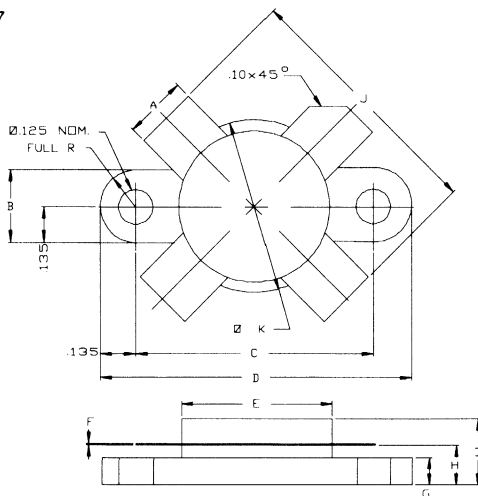
MOUNTING CIRCUIT





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0177

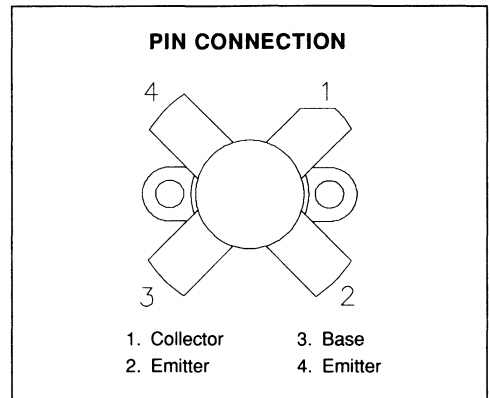
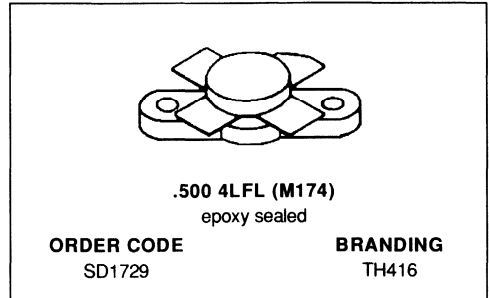


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.225/5,72	.235/5,97	K	.625/15,88	.635/16,13
B	.265/6,73	.275/6,96			
C	.860/21,84	.870/22,10			
D	1.130/28,70	1.140/28,96			
E	.545/13,84	.555/14,10			
F	.003/0,08	.007/0,18			
G	.100/2,54	.118/3,00			
H	.150/3,81	.170/4,32			
I		.280/7,11			
J	1.080/27,43	1.120/28,45			



## RF & MICROWAVE TRANSISTORS HF SSB APPLICATIONS

- OPTIMIZED FOR SSB
- 30 MHz
- 28 VOLTS
- IMD -30 dB
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{out} = 130$  W PEP WITH 12 dB GAIN



### DESCRIPTION

The SD1729 is a Class AB 28 V epitaxial silicon NPN planar transistor designed primarily for SSB communications. This device utilizes emitter ballasting to achieve extreme ruggedness under severe operating conditions.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	70	V
$V_{CEO}$	Collector-Emitter Voltage	35	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	12	A
$P_{DISS}$	Power Dissipation	175	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.0	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

# SD1729 (TH416)

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 50mA	V <sub>BE</sub> = 0V	70	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 100mA	I <sub>B</sub> = 0mA	35	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 20mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CES</sub>	V <sub>CE</sub> = 35V	I <sub>E</sub> = 0mA	—	—	20	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 7A	18	—	50	—

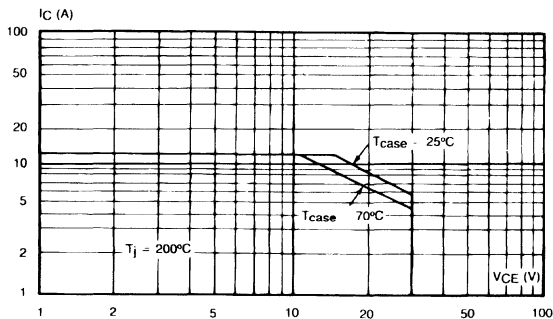
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 30 MHz	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 150 mA	130	—	—	W
G <sub>P</sub>	P <sub>OUT</sub> = 130 W PEP	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 150 mA	12	—	—	dB
IMD*	P <sub>OUT</sub> = 130 W PEP	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 150 mA	—	—	-30	dBc
η <sub>C</sub>	P <sub>OUT</sub> = 130 W PEP	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 150 mA	37	—	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	220	—	pF

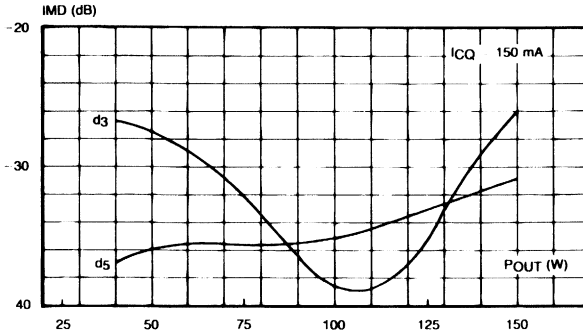
Note: \* f<sub>1</sub> = 30.00 MHz, I<sub>2</sub> = 30.001 MHz

## TYPICAL PERFORMANCE

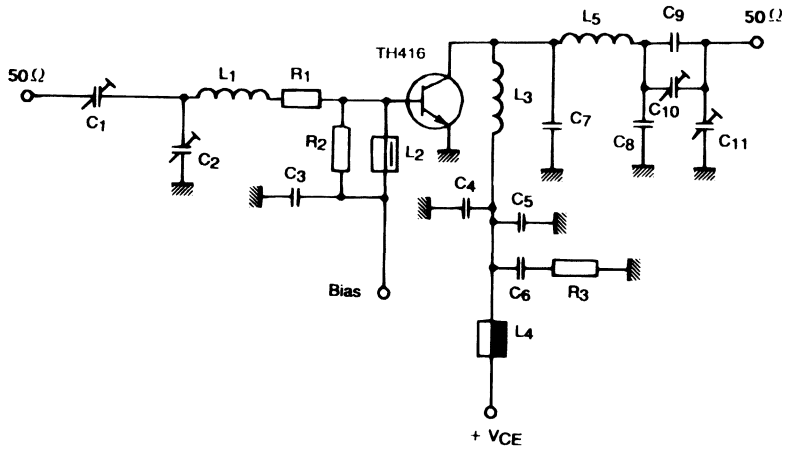
### SAFE OPERATING AREA



## TYPICAL PERFORMANCE (cont'd)

INTERMODULATION DISTORTION vs  
POWER OUTPUT

## TEST CIRCUIT



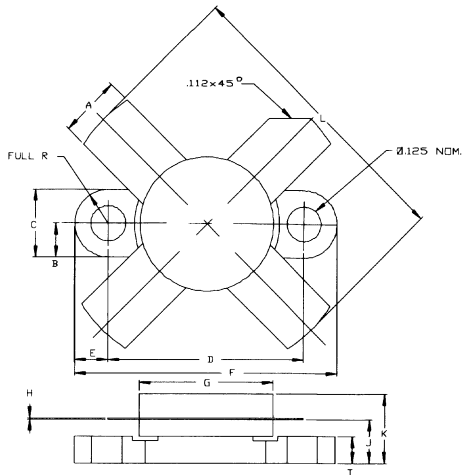
C1 : 20 - 120pF  
 C2 : 50 - 300pF  
 C3, C4 : 3.9nF  
 C5 : 100nF  
 C6 : 2.2μF  
 C7 : 2 x 180pF in Parallel  
 C8 : 3 x 56pF and 33pF in Parallel  
 C9 : 4 x 56pF and 68pF in Parallel  
 C10, C11 : 360pF

L1 : 88nF  
 L2 : 22μH Choke Coil  
 L3, L5 : 80nF  
 L4 : Ferroxcube Choke Coil

R1 : 0.55Ω  
 R2 : 27Ω  
 R3 : 4.7Ω

PACKAGE MECHANICAL DATA

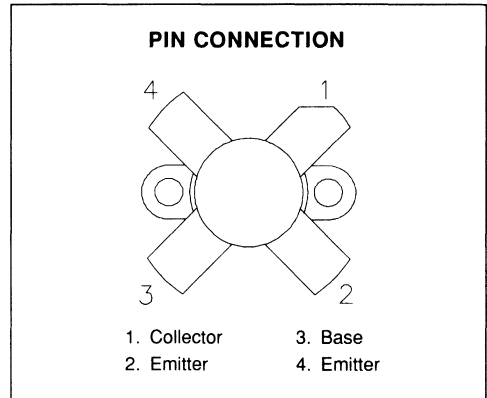
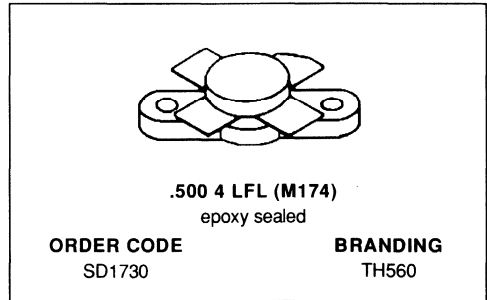
Ref.: Dwg. No.12-0174



SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K	
B	.125/3,18		L	1.050/26,67
C	.245/6,22	.255/6,48		
D	.720/18,28	.730/18,54		
E	.125/3,18			
F	.970/24,64	.980/24,89		
G	.495/12,57	.505/12,83		
H	.003/0,08	.007/0,18		
I	.090/2,29	.110/2,79		
J	.160/4,06	.175/4,45		

**RF & MICROWAVE TRANSISTORS  
 HF SSB APPLICATIONS**

- OPTIMIZED FOR SSB
- 30 MHz
- 28 VOLTS
- IMD -30dB
- EFFICIENCY 40%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 220$  W PEP WITH 12 dB GAIN


**DESCRIPTION**

The SD1730 is a 28 V epitaxial silicon NPN planar transistor designed primarily for SSB and VHF communications. The device utilizes emitter ballasting for improved ruggedness and reliability.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	70	V
$V_{CEO}$	Collector-Emitter Voltage	35	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	16	A
$P_{DISS}$	Power Dissipation	320	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.7	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

# SD1730 (TH560)

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CES</sub>	I <sub>C</sub> = 100mA	V <sub>BE</sub> = 0V	70	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 200mA	I <sub>B</sub> = 0mA	35	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 20mA	I <sub>C</sub> = 0mA	4.0	—	—	V
I <sub>CEO</sub>	V <sub>CE</sub> = 30V	I <sub>E</sub> = 0mA	—	—	5	mA
I <sub>CES</sub>	V <sub>CE</sub> = 35V	I <sub>E</sub> = 0mA	—	—	5	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 7A	15	—	50	—

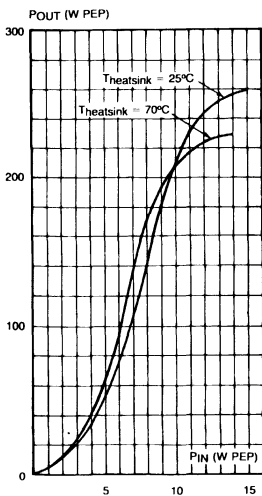
### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 30 MHz	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 750 mA	220	—	—	W
G <sub>P</sub> *	P <sub>OUT</sub> = 220 W PEP	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 750 mA	12	—	—	dB
IMD*	P <sub>OUT</sub> = 220 W PEP	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 750 mA	—	—	-30	dBc
η <sub>c</sub> *	P <sub>OUT</sub> = 220 W PEP	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 750 mA	40	—	—	%
C <sub>OB</sub>	f = 1 MHz	V <sub>CB</sub> = 28 V		—	450	—	pF
Load Mismatch	P <sub>OUT</sub> = 220 W PEP	V <sub>CE</sub> = 28 V	I <sub>CQ</sub> = 750 mA	—	∞:1	—	VSWR

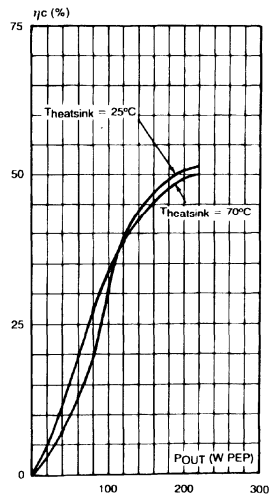
Note: \* f<sub>1</sub> = 30.00 MHz, f<sub>2</sub> = 30.001 MHz

### TYPICAL PERFORMANCE

#### POWER OUTPUT PEP vs POWER INPUT



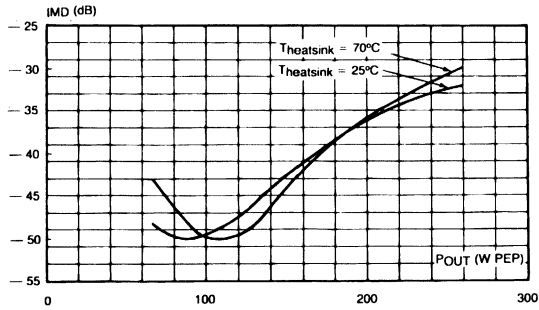
#### COLLECTOR EFFICIENCY vs POWER OUTPUT PEP



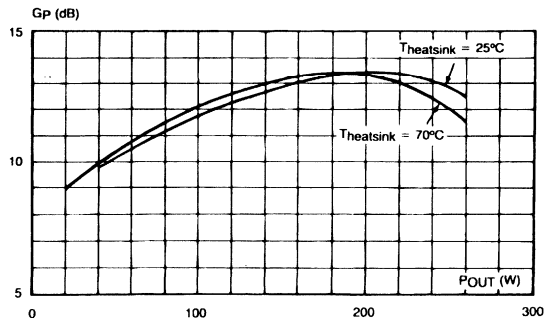


## TYPICAL PERFORMANCE (cont'd)

## INTERMODULATION DISTORTION vs POWER OUTPUT PEP



## POWER GAIN vs POWER OUTPUT

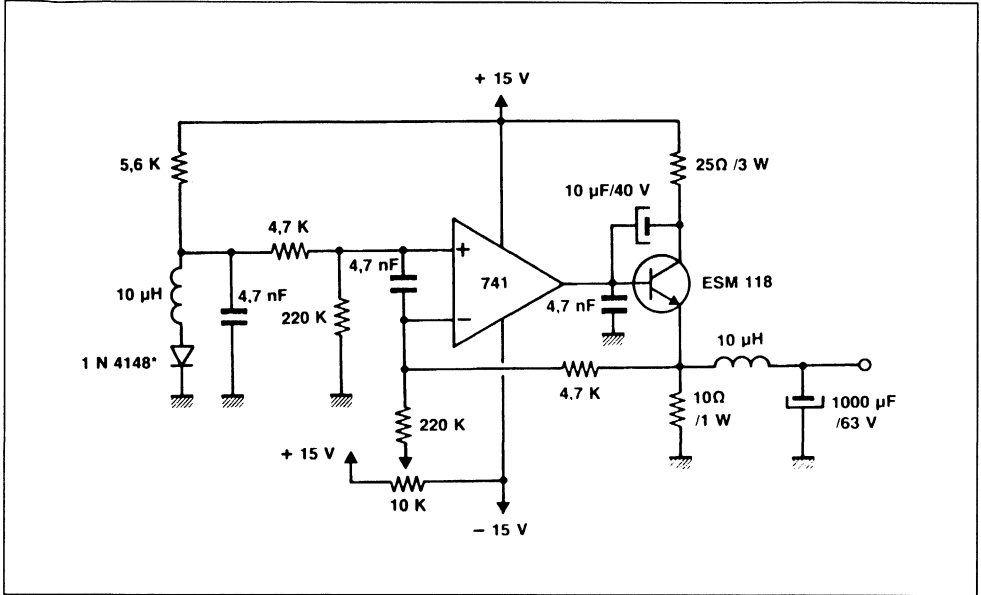


## IMPEDANCE DATA

FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
30 MHz	$1.15 + j 0.41$	$1.25 + j 1.92$

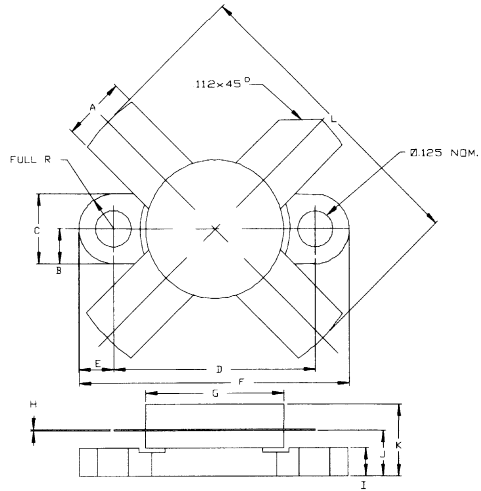


## BIAS CIRCUIT



PACKAGE MECHANICAL DATA

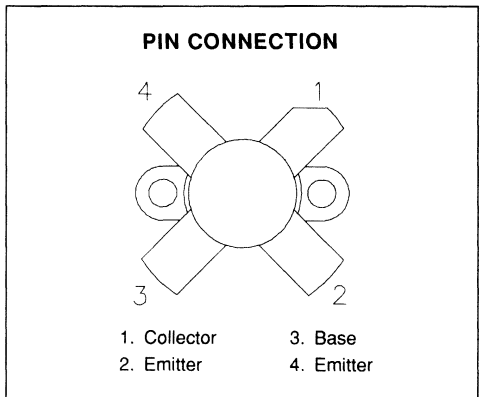
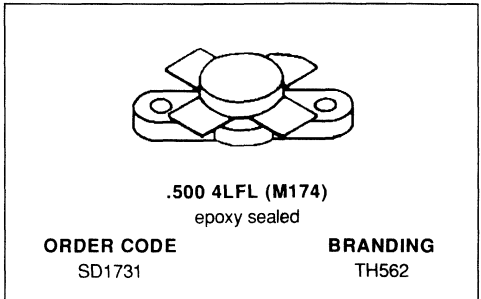
Ref.: Dwg. No.12-0174



SGS-THOMSON MICROELECTRONICS		CONT'D	
MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	
B	.125/3,18		K
C	.245/6,22	.255/6,48	L
D	.720/18,28	.730/18,54	
E	.125/3,18		
F	.970/24,64	980/24,89	
G	495/12,57	505/12,83	
H	.003/0,08	.007/0,18	
I	.090/2,29	110/2,79	
J	.160/4,06	.175/4,45	

## RF & MICROWAVE TRANSISTORS HF SSB APPLICATIONS

- OPTIMIZED FOR SSB
- 30 MHz
- 50 VOLTS
- EFFICIENCY 40%
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 220$  W PEP WITH 13 dB GAIN



### DESCRIPTION

The SD1731 is a 50 V epitaxial silicon NPN planar transistor designed primarily for SSB communications. This device utilizes emitter ballasting for improved ruggedness and reliability.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	110	V
$V_{CEO}$	Collector-Emitter Voltage	55	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	12	A
$P_{DISS}$	Power Dissipation	320	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.7	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**SD1731 (TH562)****ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 200mA$	$I_E = 0mA$	110	—	—	V
$BV_{CEO}$	$I_C = 200mA$	$I_B = 0mA$	55	—	—	V
$BV_{EBO}$	$I_E = 20mA$	$I_C = 0mA$	4.0	—	—	V
$I_{CEO}$	$V_{CE} = 30V$	$I_E = 0mA$	—	—	5	mA
$I_{CES}$	$V_{CE} = 55V$	$I_E = 0mA$	—	—	10	mA
$h_{FE}$	$V_{CE} = 6V$	$I_C = 10A$	15	—	80	—

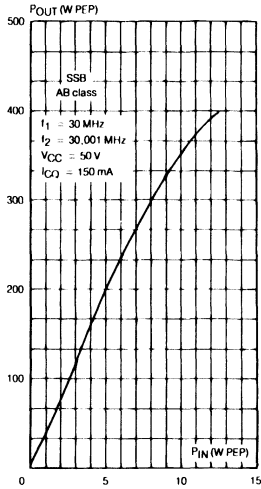
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 30\text{ MHz}$	$V_{CE} = 50\text{ V}$	$I_{CQ} = 150\text{ mA}$	220	—	—	W
$GP^*$	$P_{OUT} = 220\text{ W PEP}$	$V_{CE} = 50\text{ V}$	$I_{CQ} = 150\text{ mA}$	13	—	—	dB
$IMD^*$	$P_{OUT} = 220\text{ W PEP}$	$V_{CE} = 50\text{ V}$	$I_{CQ} = 150\text{ mA}$	—	—	-30	dBc
$\eta_C^*$	$P_{OUT} = 220\text{ W PEP}$	$V_{CE} = 50\text{ V}$	$I_{CQ} = 150\text{ mA}$	40	—	—	%
$C_{OB}$	$f = 1\text{ MHz}$	$V_{CB} = 50\text{ V}$		—	330	—	pF

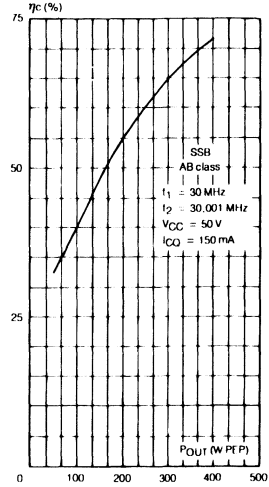
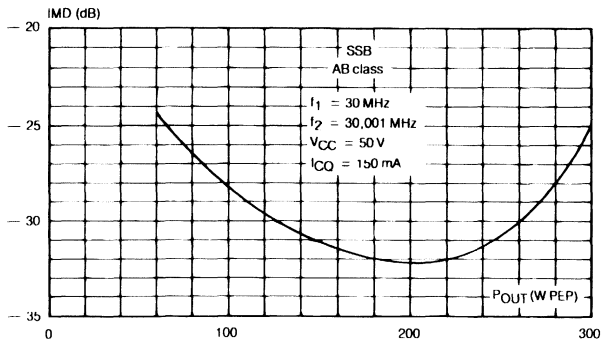
Note:  $*f_1 = 30.00\text{ MHz}$ ,  $f_2 = 30.001\text{ MHz}$

## TYPICAL PERFORMANCE

POWER OUTPUT PEP vs POWER INPUT

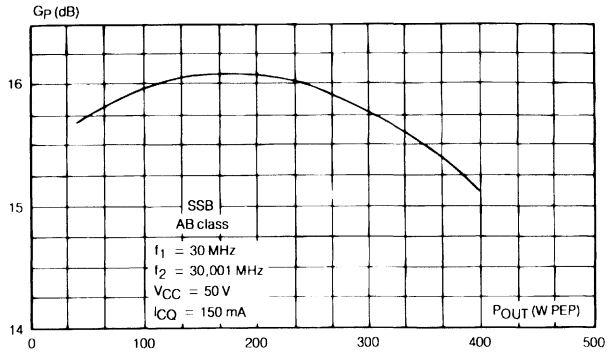


COLLECTOR EFFICIENCY vs POWER OUTPUT PEP

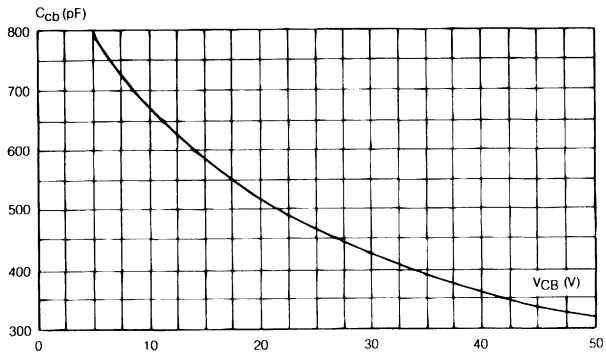
INTERMODULATION DISTORTION  
vs POWER OUTPUT PEP

TYPICAL PERFORMANCE

POWER GAIN vs POWER OUTPUT PEP

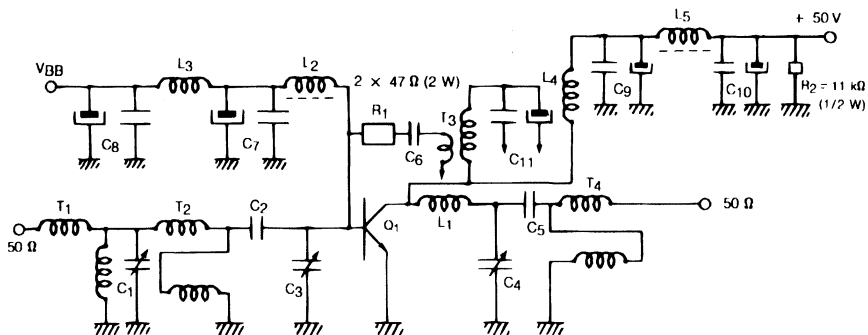


COLLECTOR BASE CAPACITANCE vs COLLECTOR EMITTER VOLTAGE



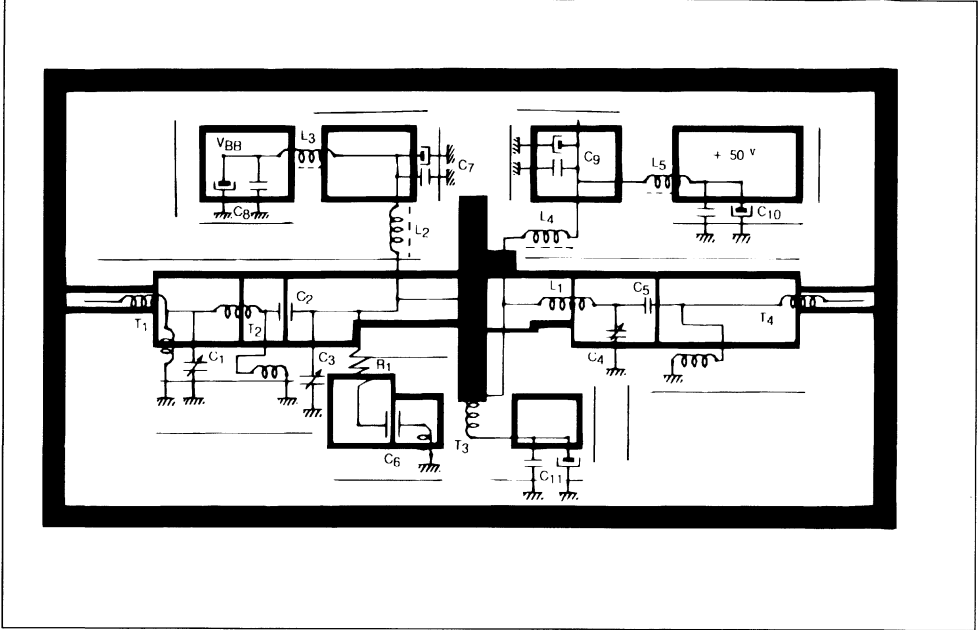


## TEST CIRCUIT

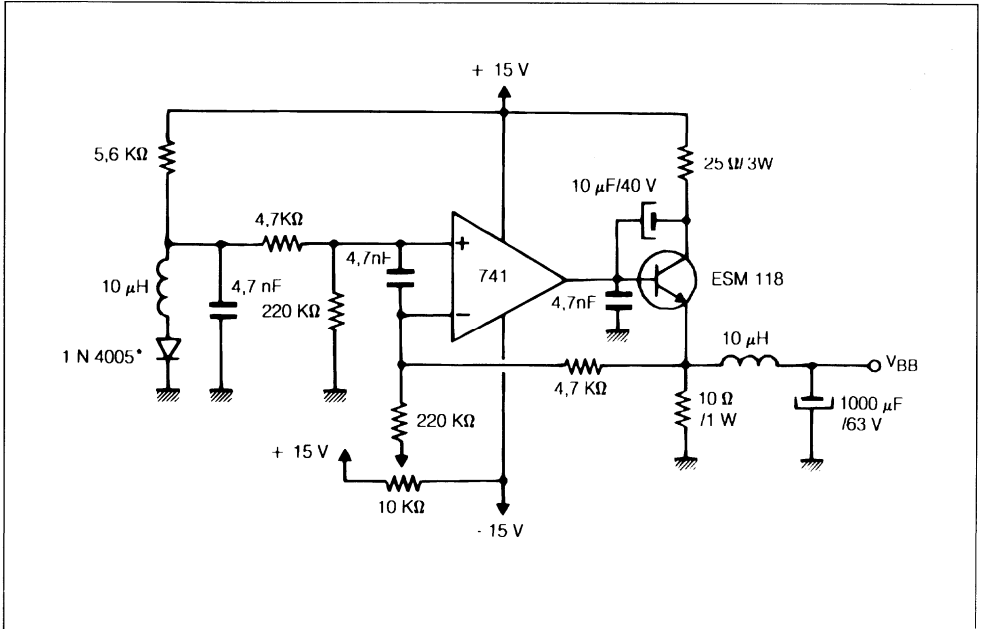


C1	: Arco 426 + 220pF + 330pF Chips	L4	: 10 Turns of 1.2mm Enameled Wire, Diameter 8.1mm, Length 20mm
C2	: 2 x 10nF Chips	L5	: 7 Turns of 1.2mm Enameled Wire on Ferrite Core Phillips 4C6 97180
C3	: Arco 4615 + 2.2nF + 2 x 1nF LCC + 4.7nF + 560pf Chps	T1	: 6:3.5 Impedance Transformer on toriod Phillips 4C6 97180
C4	: Arco 4213 + 330pF Chip	T2	: Twisted Pair 4:1 Transformer, 4 Turns Made with 1.0mm Enameled on toriod Phillips 4C6 97180
C5	: 10nF Chip	T3	: Feedback Transformer
C6	: 3 x 10nF Chips	T4	: Twisted Pair 4:1 Transformer, 4 Turns of bifilar Twisted 1.2mm Wires on Ferrite Core Phillips 4C6 97200
C7, C8, C9,	1nF + 10nF + 100nF + 4.7μF, 63V + 100μF, 63V		
C10, C11:			
L1	: 3 Turns of 1.2mm Unenameled Wire Diameter, 7.1mm, Length 13mm		
L2, L3	: 8 Turns of 0.55mm Enameled Wire on Ferrite Core Phillips 4C6 97170 (9 x 6 x 3)		

MOUNTING CIRCUIT

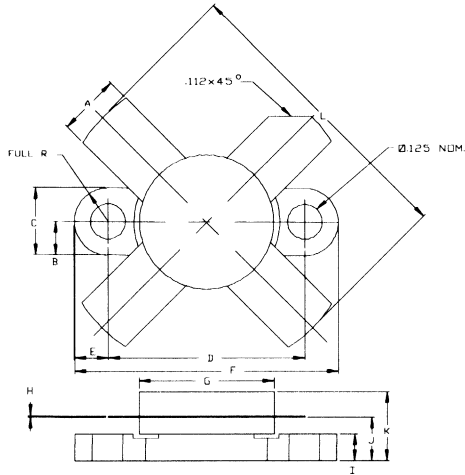


BIAS CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0174

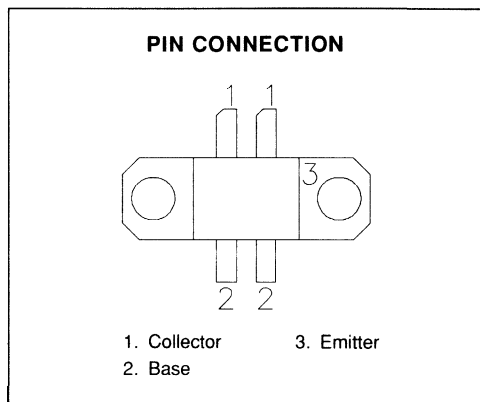
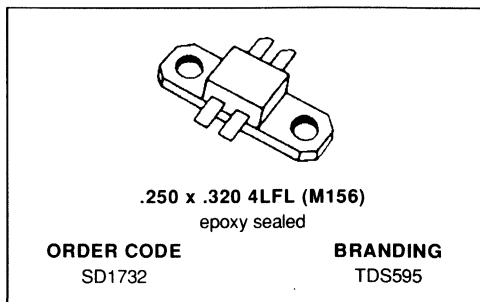


SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K	.280/7,11
B	.125/3,18		L	1.050/26,67
C	.245/6,22	.255/6,48		
D	.720/18,28	.730/18,54		
E	.125/3,18			
F	.970/24,64	.980/24,89		
G	.495/12,57	.505/12,83		
H	.003/0,08	.007/0,18		
I	.090/2,29	.110/2,79		
J	.160/4,06	.175/4,45		



**RF & MICROWAVE TRANSISTORS  
 TV LINEAR APPLICATIONS**

- 470 - 860 MHz
- 25 VOLTS
- CLASS A PUSH PULL
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- GOLD METALLIZATION
- DIFFUSED EMITTER BALLAST RESISTORS
- COMMON EMITTER CONFIGURATION
- INTERNAL INPUT MATCHING
- $P_{OUT} = 14.0$  W MIN. WITH 8.5 dB GAIN


**DESCRIPTION**

The SD1732 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class A operation in UHF and Band IV, V television transmitters and transposers.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	25	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_c$	Device Current	2 x 2.6	A
$P_{DISS}$	Power Dissipation	65	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.5	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

## SD1732 (TDS595)

### ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

#### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 20mA$	$I_E = 0mA$	45	—	—	V
$BV_{CEO}$	$I_C = 40mA$	$I_B = 0mA$	25	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.0	—	—	V
$h_{FE}$	$V_{CE} = 20V$	$I_C = 0.5A$	10	—	—	—

#### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 845 MHz$	$V_{CE} = 25 V$	$I_{CQ} = 2 \times 850 mA$	14	—	—	W
$G_P$	$P_{OUT} = 14 W$	$V_{CE} = 25 V$	$I_{CQ} = 2 \times 850 mA$	8.5	—	—	dB
$IMD_3^*$	$P_{OUT} = 14 W$	$V_{CE} = 25 V$	$I_{CQ} = 2 \times 850 mA$	—	-47	—	dBc
$CMD^{**}$	$P_{OUT} = 14 W$	$V_{CE} = 25 V$	$I_{CQ} = 2 \times 850 mA$	—	20	—	%
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 25 V$		—	—	20	pF

Note: \*IMD 3 Tone Testing

Vision Carrier -8 dB ref

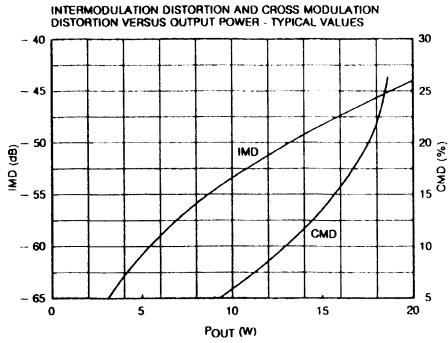
Sound Carrier -7 dB ref

Sideband Carrier -16 dB ref

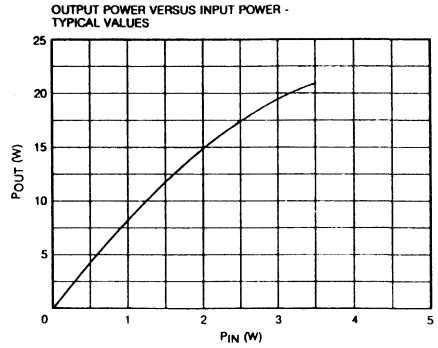
\*\* CMD: Cross Modulation Distortion of the Voltage Variation (%) of Sound Carrier When Vision Carrier is Switched from 0 to -20 dB

## TYPICAL PERFORMANCE

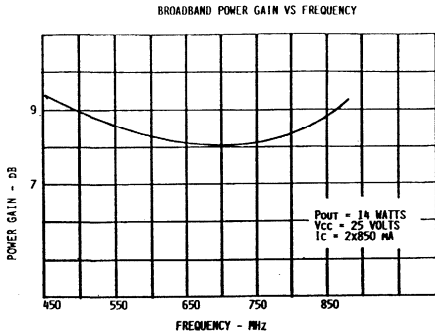
## INTERMODULATION DISTORTION &amp; CROSS MODULATION DISTORTION vs POWER OUTPUT



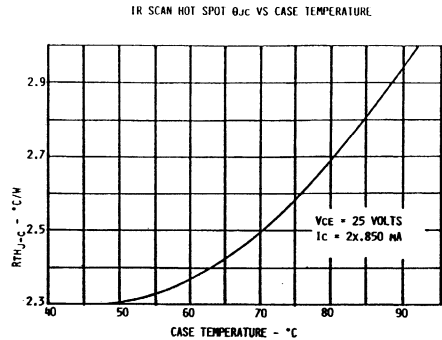
## POWER OUTPUT vs POWER INPUT



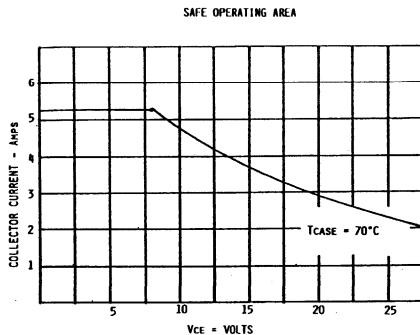
## BROADBAND POWER GAIN vs FREQUENCY



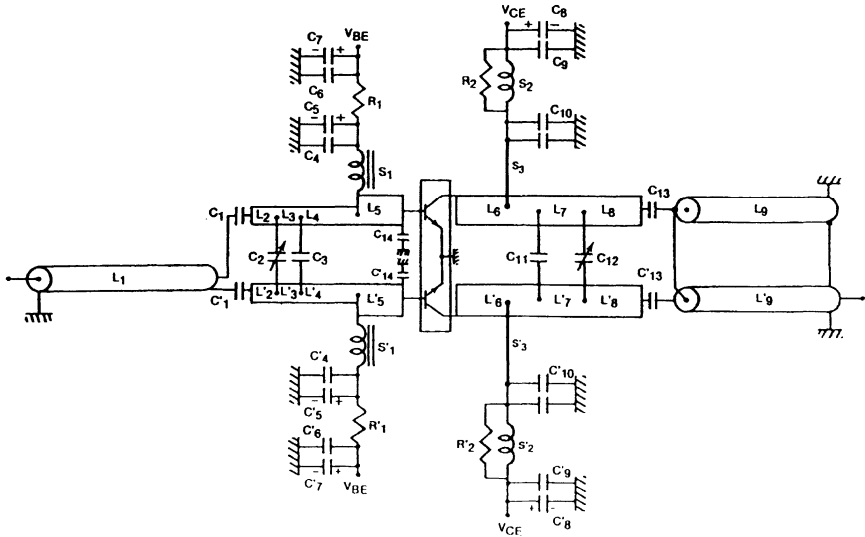
## THERMAL RESISTANCE vs CASE TEMPERATURE



## SAFE OPERATING AREA



TEST CIRCUIT



- C1, C'1, C13, C'13 : 68pF, ATC 100A
- C2 : 4.5pF Adjustable Johanson
- C3 : 4.7pF, ATC 100A
- C4, C'4, C6, C'6, C9, C'9, C10, C'10 : 100pF, ATC 100A + 1nF LCC Chip + 10nF LCC Chip
- C5, C'5 : 4.7μF, 25V, Tantalum Capacitor
- C7, C'7 : 10μF, 25V, Tantalum Capacitor
- C8, C'8 : 22μF, 35V, Tantalum Capacitor
- C11 : 4.7pf, ATC 100A
- C12 : 8pF Adjustable Johanson
- C14, C'14 : 22pF, ATC 100A

- L3, L'3 : 50Ω Printed Transmission Line Length 3mm
- L4, L'4 : 50Ω Printed Transmission Line Length 9.5mm
- L5, L'5 : 39Ω Printed Transmission Line Length 7mm
- L6, L'6 : 39Ω Printed Transmission Line Length 15mm
- L7, L'7 : 39Ω Printed Transmission Line Length 8mm
- L8, L'8 : 39Ω Printed Transmission Line Length 10mm

- R1, R'1 : 4.7Ω, 1/2W
- R2, R'2 : 1207Ω, 1/2W

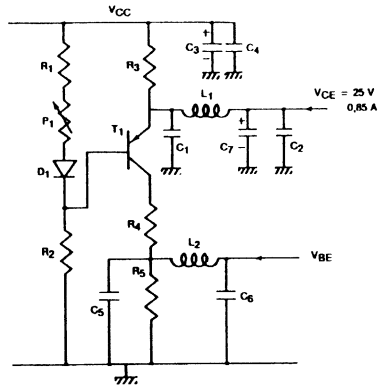
- S1, S'1 : 470nH Molded
- S2, S'2 : 5 Turns, Diameter Wire 0.5mm on 3mm I.D.
- S3, S'3 : Diameter Wire 1.2mm, Length 12mm

- L1, L9, L'9 : 50Ω Coaxial Wire Diameter 2.2mm, Length 29mm on 70Ω Transmission Line
- L2, L'2 : 50Ω Printed Transmission Line Length 4mm

Substrate: Teflon Glass 30Mils, Er = 2.55

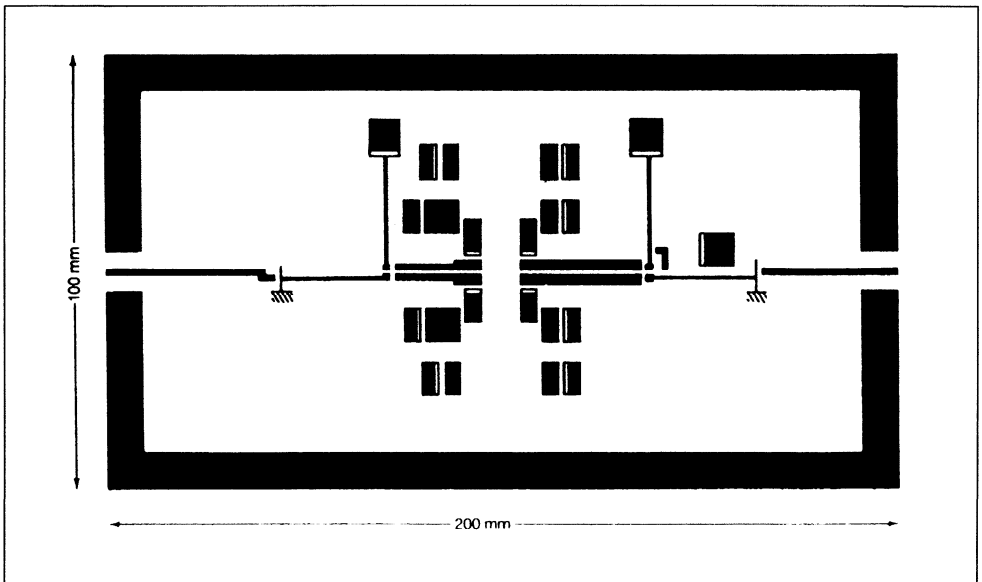


## SUPPLY CIRCUIT - CLASS A ADJUSTABLE (per side)



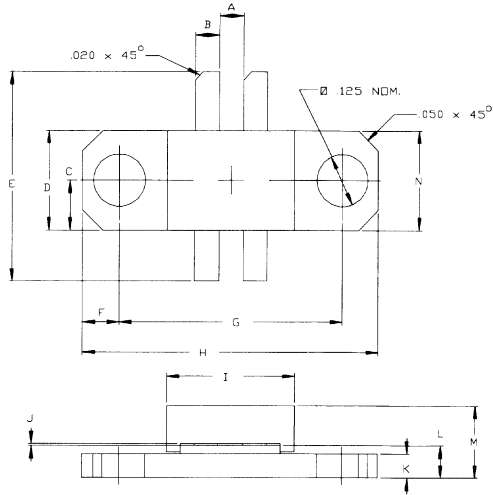
C1, C2, C4,	P1	: 1k $\Omega$
C5, C6	R1	: 56 $\Omega$ , 1/2W
: 1nF LCC Chip + 10nF LCC Chip	R2	: 5600 $\Omega$ , 1/2W
C3	R3	: 2.2 $\Omega$ , 3W
: 100 $\mu$ F Sprague	R4, R5	: 56 $\Omega$ , 1W
C7	T1	: BDX 54 B
: 10 $\mu$ F Sprague		
D1		
: 1N 4001		
L1, L2		
: 5 Turns, 0.5mmWire on 3mm Internal Diameter		

## PHOTOMASTER OF TEST CIRCUIT



PACKAGE MECHANICAL DATA

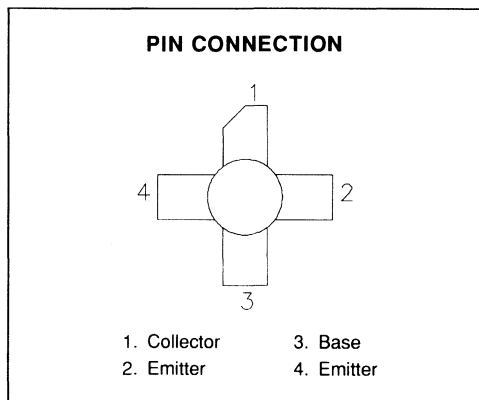
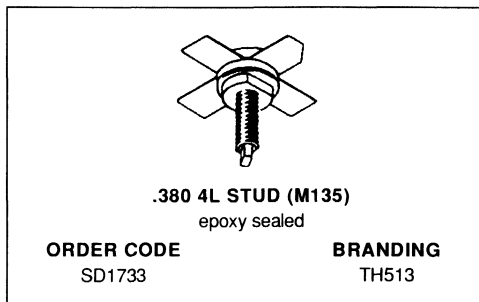
Ref.: Dwg. No.12-0156



SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.060/1,52		K	.055/1,40	.065/1,65
B	.055/1,40	.065/1,65	L	.075/1,91	.095/2,41
C	.124/3,15		M		.190/4,83
D	.243/6,17	.253/6,43	N	.245/6,22	.257/6,53
E	.635/16,13	.665/16,89			
F	.092/2,34				
G	.555/14,10	.565/14,35			
H	.739/18,77	.749/19,02			
I	.315/8,00	.327/8,31			
J	.002/0,05	.006/0,15			

**RF & MICROWAVE TRANSISTORS  
 HF SSB APPLICATIONS**

- OPTIMIZED FOR SSB
- 30 MHz
- 50 VOLTS
- COMMON EMITTER
- GOLD METALLIZATION
- $P_{OUT} = 75 \text{ W MIN. WITH } 14.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1733 is a 50 V Class AB epitaxial silicon NPN planar transistor designed primarily for SSB and VHF communications. This device utilizes emitter ballasting for improved ruggedness and reliability.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	110	V
$V_{CEO}$	Collector-Emitter Voltage	55	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current	3.25	A
$P_{DISS}$	Power Dissipation	127	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

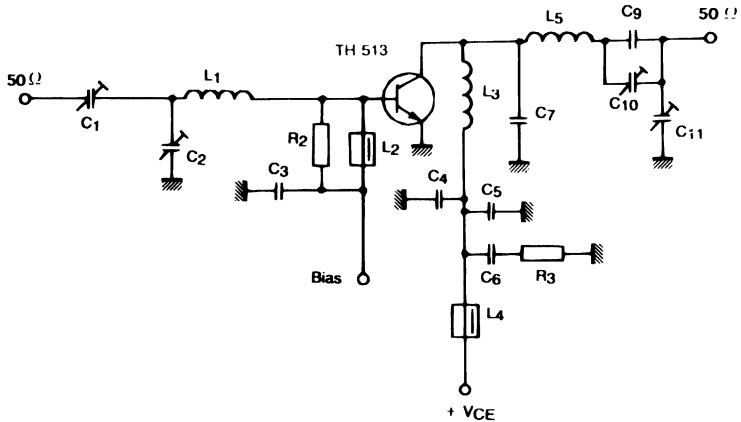
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CES}}$	$I_{\text{C}} = 100\text{mA}$	$V_{\text{BE}} = 0\text{V}$	110	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 200\text{mA}$	$I_{\text{B}} = 0\text{mA}$	55	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	4.0	—	—	V
$h_{\text{FE}}$	$V_{\text{CE}} = 6\text{V}$	$I_{\text{C}} = 1.4\text{A}$	19	—	50	—

## DYNAMIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 30\text{ MHz}$	$V_{\text{CE}} = 50\text{ V}$	75	—	—	W
$G_{\text{P}}^*$	$P_{\text{OUT}} = 75\text{ W PEP}$	$V_{\text{CE}} = 50\text{ V}$	14	—	—	dB
$\text{IMD}^*$	$P_{\text{OUT}} = 75\text{ W PEP}$	$V_{\text{CE}} = 50\text{ V}$	—	—	-30	dBc
$\eta_{\text{C}}^*$	$P_{\text{OUT}} = 75\text{ W PEP}$	$V_{\text{CE}} = 50\text{ V}$	37	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 50\text{ V}$	—	—	100	pF

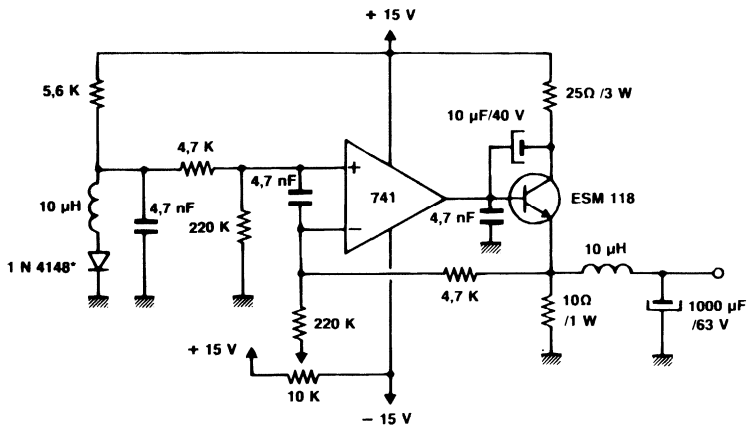
Note: \*  $f_1 = 30.00\text{ MHz}$ ,  $f_2 = 30.001\text{ MHz}$

## TEST CIRCUIT



C1	: 20 - 500pF	L1	: 3 Turns, Diameter Wire 1.5mm, Int. Diameter 7mm, Pitch 2.5mm
C2	: 50 - 500pF	L2	: 22 $\mu$ H Choke Coil
C3, C4	: 3.9nF	L3	: 4 Turns, Diameter Wire 1.5mm, Int. Diameter 10mm, Pitch 2.5mm
C5	: 100nF	L4	: Ferroxcube Choke Coil
C6	: 2.2 $\mu$ F	L5	: 7 Turns, Diameter Wire 1.5mm, Int. Diameter 12mm, Pitch 2.5mm
C7	: 56pF	R2	: 33 $\Omega$
C9	: 100pF	R3	: 4.7 $\Omega$
C10	: 20 - 150pF		
C11	: 20 - 500pF		

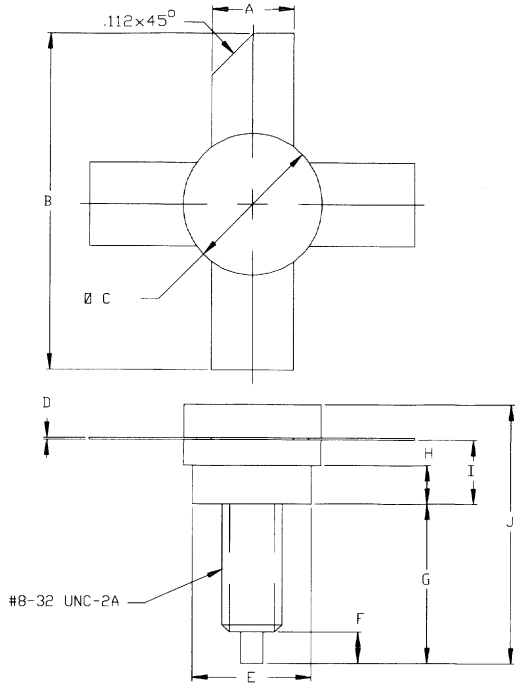
## BIAS CIRCUIT



## PACKAGE MECHANICAL DATA

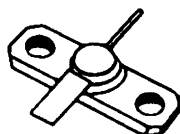
Ref.: Dwg. No.12-0135

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84
B	.980/24,89	
C	.370/9,40	.385/9,78
D	.004/0,10	.007/0,18
E	.320/8,13	.330/8,38
F	.100/2,54	.130/3,30
G	.450/11,43	.490/12,45
H	.090/2,29	.100/2,54
I	.155/3,94	.175/4,45
J		.750/19,05



## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- 2.3 GHz
- 15 VOLTS
- CLASS A
- OVERLAY GEOMETRY
- GOLD METALLIZATION
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = .2W$  MIN. WITH 11.0 dB GAIN

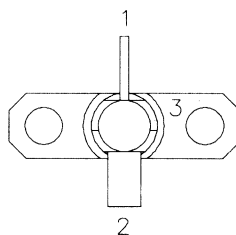


.230 2LFL (M151)  
hermetically sealed

**ORDER CODE**  
SD1850

**BRANDING**  
SD1850

### PIN CONNECTION



1. Collector                      3. Emitter  
2. Base

### DESCRIPTION

The SD1850 is a silicon NPN planar transistor designed for high gain linear performance at 2.0 GHz. This part uses gold metallized die and polysilicon site ballasting to achieve high reliability and ruggedness. The part can be used for applications such as Telecommunications, radar ECM, space and other commercial and military systems.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	30	V
$V_{CES}$	Collector-Emitter Voltage	15	V
$V_{EBO}$	Emitter-Base Voltage	2.0	V
$I_C$	Device Current	0.1	A
$P_{DISS}$	Power Dissipation	3.9	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	45	$^{\circ}C/W$
---------------	----------------------------------	----	---------------

ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 5mA	I <sub>E</sub> = 0mA	30	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 5mA	I <sub>B</sub> = 0mA	15	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	2.0	—	—	V
h <sub>FE</sub>	V <sub>CE</sub> = 3V	I <sub>C</sub> = 50mA	20	—	150	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 2.3 GHz	V <sub>CE</sub> = 15 V	I <sub>CQ</sub> = 80 mA	.2	—	—	W
G <sub>P</sub>	f = 2.3 GHz	V <sub>CE</sub> = 15 V	I <sub>CQ</sub> = 80 mA	11	—	—	dB

Note: 1 dB Compression point

## S-PARAMETER DATA

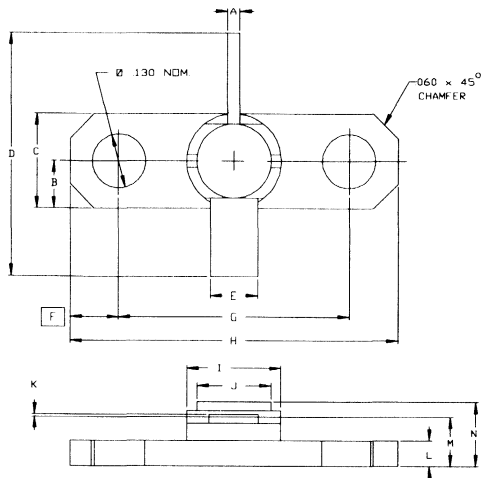
BIAS: Current = 60mA, Voltage = 15 Volts

Frequency	Return Loss-in		Gain Forward			Hfe	Loss-reverse		Return Loss-out	
	S11		S21				S12		S22	
MHz	DB	ANG	DB	MAG	ANG	DB	ANG	DB	ANG	
500	2.35	- 173.8	+ 18.80	6.76	78.1	- 10.9389	29.59	31.4	9.70	- 141.8
1000	2.32	172.5	+ 11.10	3.59	53.6	- 6.8204	25.67	40.1	7.88	- 184.5
1500	2.54	160.2	+ 7.54	2.38	31.2	- 5.2930	23.35	41.5	6.02	179.7
2000	2.93	147.7	+ 5.82	1.98	11.0	- 4.5951	20.70	37.4	4.34	166.2
2500	3.9	129.0	+ 4.3	1.64	- 10.0	- 3.2462	18.6	32.0	3.3	148.0
3000	5.3	98.0	+ 2.9	1.40	- 35.0	- 2.6655	17.1	17.0	1.9	133.0
3500	7.4	51.0	+ 1.8	1.20	- 58.0	- 3.0508	15.9	- 2.0	1.0	120.0
4000	8.3	- 22.0	+ 0.1	1.01	- 83.0	- 3.1661	15.7	- 22.0	0.6	108.0



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0192

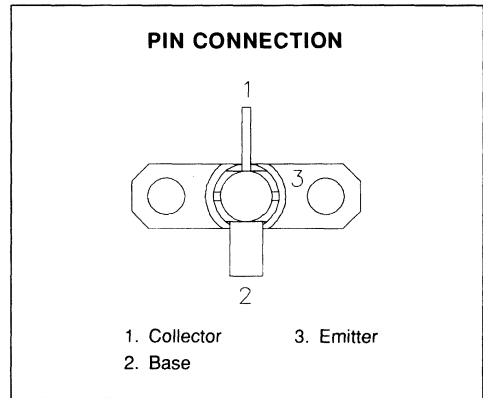
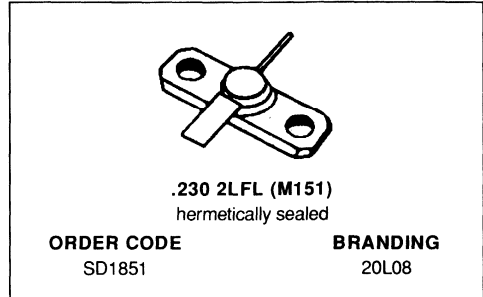


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.025/0,64	.035/0,89	K	.003/0,08	.007/0,18
B	.115/2,92	NDM.	L	.055/1,40	.067/1,70
C	.225/5,72	.235/5,97	M	.120/3,18	.140/3,56
D	.710/18,03	.750/19,05	N		.170/4,32
E	.110/2,79	.120/3,05			
F	.120/3,05	NDM.			
G	.555/14,10	.565/14,35			
H	.795/20,19	.805/20,45			
I	.222/5,64	.236/5,99			
J	.165/4,19	.185/4,70			



**RF & MICROWAVE TRANSISTORS  
 GENERAL PURPOSE LINEAR APPLICATIONS**

- 2.0 GHz
- 20 VOLTS
- CLASS A
- OVERLAY GEOMETRY
- GOLD METALLIZATION
- COMMON EMITTER CONFIGURATION
- P<sub>OUT</sub> = .8 W MIN. WITH 8.0 dB GAIN


**DESCRIPTION**

The SD1851 is a silicon NPN planar transistor designed for high gain linear performance at 2.0 GHz. This part uses gold metallized die and polysilicon site ballasting to achieve high reliability and ruggedness. The part can be used for applications such as telecommunications, radar, ECM, space and other commercial and military systems.

**ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)**

Symbol	Parameter	Value	Unit
V <sub>CB0</sub>	Collector-Base Voltage	40	V
V <sub>CE0</sub>	Collector-Emitter Voltage	21	V
V <sub>EB0</sub>	Emitter-Base Voltage	3.5	V
I <sub>C</sub>	Device Current	0.15	A
P <sub>DISS</sub>	Power Dissipation	5.8	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

**THERMAL DATA**

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	30	°C/W
----------------------	----------------------------------	----	------

# SD1851 (TCC20L08)

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 1mA	I <sub>E</sub> = 0mA	40	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 5mA	I <sub>B</sub> = 0mA	22	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 1mA	I <sub>C</sub> = 0mA	3.5	—	—	V
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 100mA	15	—	150	—

### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
PO <sub>UT</sub> *	f = 2.0 GHz	V <sub>CE</sub> = 20 V	I <sub>CQ</sub> = 120 mA	0.8	—	—	W
GP*	f = 2.0 GHz	V <sub>CE</sub> = 20 V	I <sub>CQ</sub> = 120 mA	8.0	—	—	dB

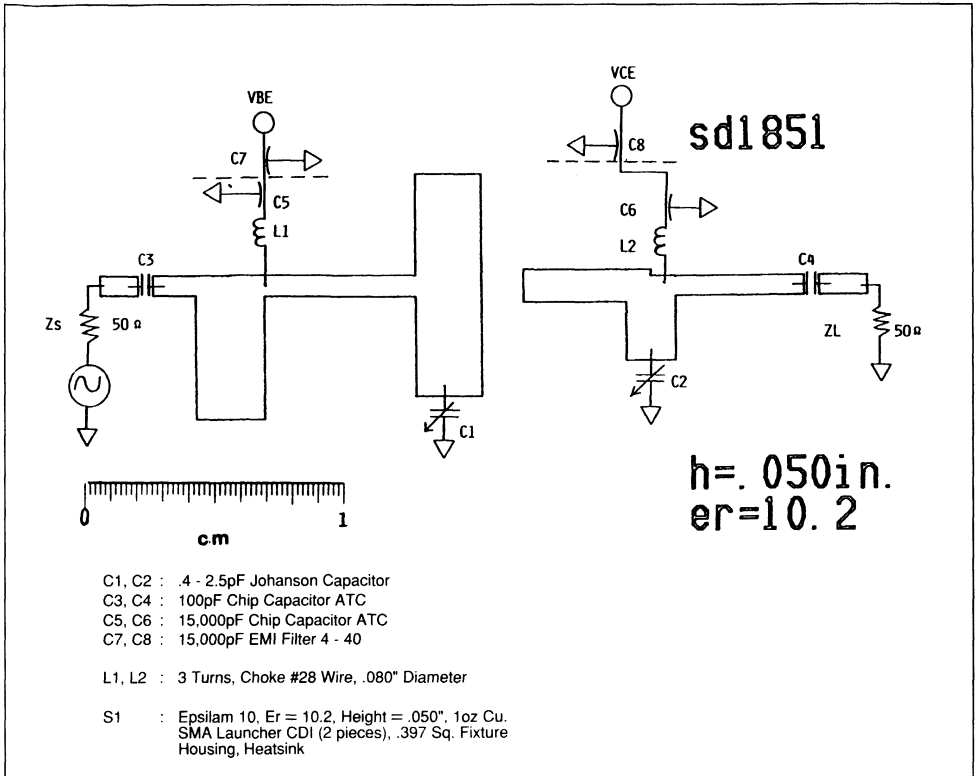
Note: \* 1 dB Compression

## S-PARAMETER DATA

BIAS: Voltage = 20 Volts

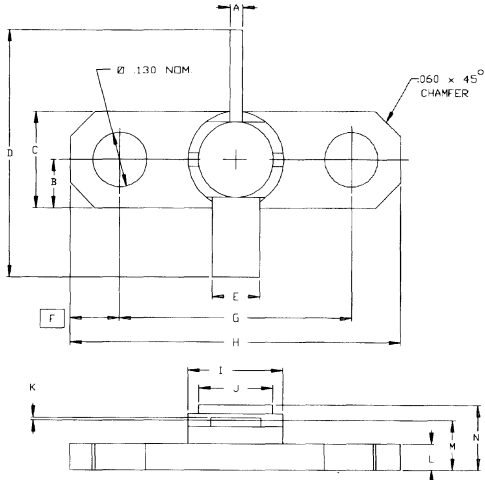
Frequency MHz	S11		S21		S12		S22	
	Mag	Ang	Mag	Ang	Mag	Ang	Mag	Ang
500	.914	178.6	4.446	77.3	.022	28.6	.227	-108.
1000	.906	168.9	2.317	58.8	.026	43.6	.323	-123.
1500	.876	159.0	1.590	40.7	.035	55.3	.426	-138.
2000	.845	146.4	1.270	22.4	.050	62.3	.498	-152.
2500	.811	130.7	1.088	8.4	.073	59.7	.569	-168.
3000	.744	105.3	.931	10.9	.107	54.5	.618	175

## TEST CIRCUIT



PACKAGE MECHANICAL DATA

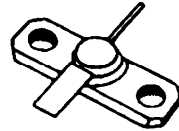
Ref.: Dwg. No.12-0192



SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.025/0,64	.035/0,89	K	.003/0,08	.007/0,18
B	.115/2,92 NDM.		L	.055/1,40	.067/1,70
C	.225/5,72	.235/5,97	M	.120/3,18	.140/3,56
D	.710/18,03	.750/19,05	N		.170/4,32
E	.110/2,79	.120/3,05			
F	.120/3,05 NDM.				
G	.555/14,10	.565/14,35			
H	.795/20,19	.805/20,45			
I	.222/5,64	.236/5,99			
J	.165/4,19	.185/4,70			

## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- 2.0 GHz
- 20 VOLTS
- CLASS A
- OVERLAY GEOMETRY
- GOLD METALLIZATION
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = 1.5 \text{ W MIN. WITH } 7.0 \text{ dB GAIN}$

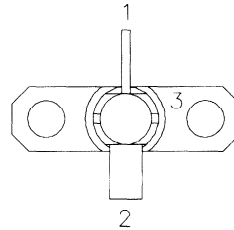


**.230 2LFL (M151)**  
hermetically sealed

**ORDER CODE**  
SD1853

**BRANDING**  
20L15

### PIN CONNECTION



1. Collector      3. Emitter  
2. Base

### DESCRIPTION

The SD1853 is a silicon NPN planar transistor designed for high gain linear performance at 2.0 GHz. This part uses gold metallized die and polysilicon site ballasting to achieve high reliability and ruggedness. The SD1853 can be used for applications such as telecommunications, radar, ECM, space and other commercial and military systems.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	40	V
$V_{CEO}$	Collector-Emitter Voltage	25	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	0.25	A
$P_{DISS}$	Power Dissipation	11.7	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	15.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

## SD1853 (TCC20L15)

### ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

#### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	40	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	25	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$h_{FE}$	$V_{CE} = 5V$	$I_C = 200mA$	15	—	150	—

#### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}^*$	$f = 2.0 GHz$	$V_{CE} = 20 V$	$I_{CQ} = 220 mA$	1.5	—	—	W
$G_P^*$	$f = 2.0 GHz$	$V_{CE} = 20 V$	$I_{CQ} = 220 mA$	7.0	—	—	dB

Note: \* 1 dB Compression

#### S-PARAMETERS DATA

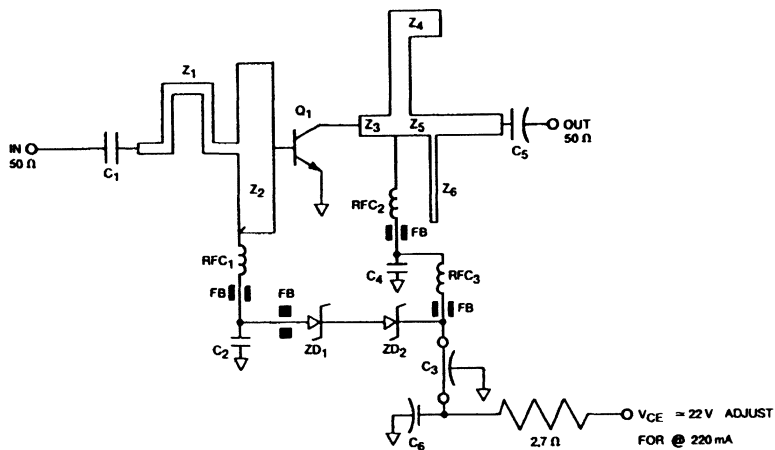
BIAS: Current = 208mA, Voltage = 20 Volts

#### FREQUENCY

MHz	S11		S21		S12		S22	
	Mag	Ang	Mag	Ang	Mag	Ang	Mag	Ang
500	.92	176.0	3.53	81.9	.03	28.2	.30	- 155.9
1000	.94	166.0	1.66	69.7	.03	45.1	.36	- 161.3
1500	.93	156.1	1.27	57.1	.04	64.3	.43	- 169.1
2000	.89	142.2	1.00	47.9	.05	70.4	.54	- 172.1
2500	.82	124.4	.88	38.9	.06	74.8	.59	- 178.2
3000	.76	97.5	.89	22.5	.08	71.5	.61	171.1
3500	.75	63.6	.93	2.1	.11	61.7	.66	156.0



## TEST CIRCUIT



C1, C2 :  
 C4, C5 : 22pF Chip Capacitor  
 C3 : 0.001 Feedthru Capacitor  
 C6 : 10 $\mu$ F, 25V

FB : Ferrite Bead

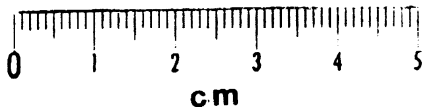
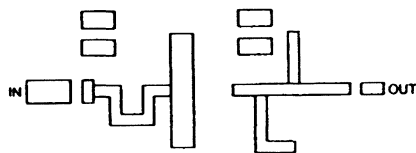
Q1 : SD1853

RFC1,  
 RFC2 : 3 Turns, AWG #28, .1" I.D.  
 RFC3 : 8 Turns, AWG #26, .15" I.D.

Z1, Z2, Z3, Z4,  
 Z5, Z6 : Microstrip on 1/32" Teflon Glass, Er = 2.55  
 ZD1 : 9V, 1W, Zener  
 ZD2 : 12V, 1W, Zener

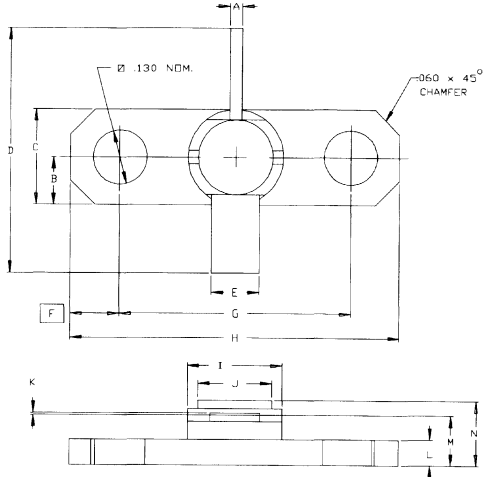
P<sub>OUT</sub> = 1 W, V<sub>CE</sub> = 22 V, FREQ = 2.3 GHz,  
 I<sub>CQ</sub> = 220 mA

P.C. ARTWORK TO SCALE



PACKAGE MECHANICAL DATA

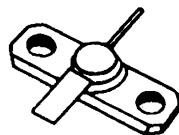
Ref.: Dwg. No.12-0192



SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.025/0,64	.035/0,89	K	.003/0,08	.007/0,18
B	.115/2,92 NDM.		L	.055/1,40	.067/1,70
C	.225/5,72	.235/5,97	M	.120/3,18	.140/3,56
D	.710/18,03	.750/19,05	N		.170/4,32
E	.110/2,79	.120/3,05			
F	.120/3,05 NDM.				
G	.555/14,10	.565/14,35			
H	.795/20,19	.805/20,45			
I	.222/5,64	.236/5,99			
J	.165/4,19	.185/4,70			

**RF & MICROWAVE TRANSISTORS  
 GENERAL PURPOSE LINEAR APPLICATIONS**

- 2.0 GHz
- 20 VOLTS
- CLASS A
- OVERLAY GEOMETRY
- GOLD METALLIZED DIE
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = 2.5W$  MIN. WITH 6.0 dB GAIN



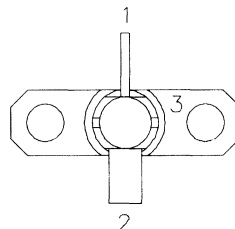
**.230 2LFL (M151)**  
hermetically sealed

**ORDER CODE**  
SD1855

**BRANDING**  
TCC20L25

**DESCRIPTION**

The SD1855 is a silicon NPN planar transistor designed for high gain linear performance at 2.0 GHz. This part uses gold metallized die and polysilicon site ballasting to achieve high reliability and ruggedness. The SD1855 can be used for applications such as telecommunications, radar, ECM, space and other commercial and military systems.

**PIN CONNECTION**


1. Collector                      3. Emitter  
2. Base

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	40	V
$V_{CES}$	Collector-Emitter Voltage	25	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	0.5	A
$P_{DISS}$	Power Dissipation	20.6	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	8.5	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

## SD1855 (TCC20L25)

### ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

#### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 2mA$	$I_E = 0mA$	40	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	25	—	—	V
$BV_{EBO}$	$I_E = 2mA$	$I_C = 0mA$	3.5	—	—	V
$h_{FE}$	$V_{CE} = 5V$	$I_C = 400mA$	15	—	150	—

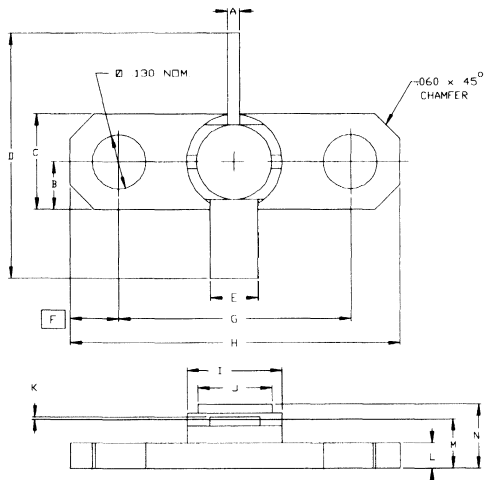
#### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}^*$	$f = 2.0 GHz$	$V_{CE} = 20 V$	$I_{CQ} = 440 mA$	2.5	—	—	W
$G_P^*$	$f = 2.0 GHz$	$V_{CE} = 20 V$	$I_{CQ} = 440 mA$	6.0	—	—	dB

Note: \* 1dB Compression

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0192

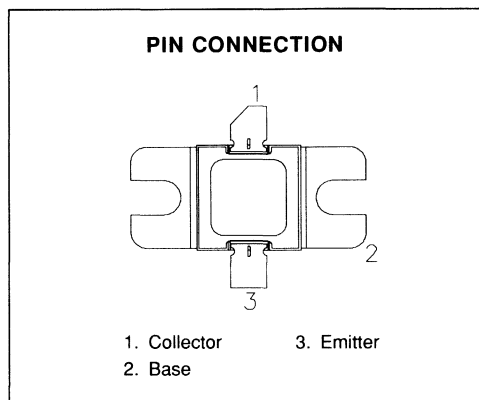
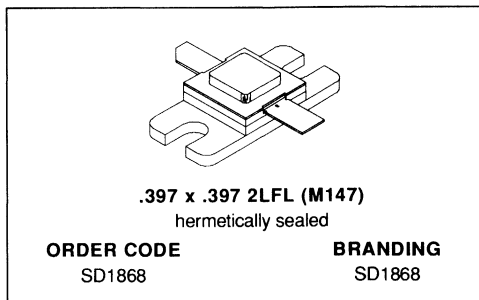


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.025/0,64	.035/0,89	K	.003/0,08	.007/0,18
B	.115/2,92 NDM.		L	.055/1,40	.067/1,70
C	.225/5,72	.235/5,97	M	120/3,18	140/3,56
D	.710/18,03	.750/19,05	N		170/4,32
E	.110/2,79	.120/3,05			
F	.120/3,05 NDM.				
G	.555/14,10	.565/14,35			
H	.795/20,19	.805/20,45			
I	.222/5,64	.236/5,99			
J	.165/4,19	.185/4,70			



**RF & MICROWAVE TRANSISTORS**  
**1.6 GHz SATCOM APPLICATIONS**

- 1.6 - 1.65 GHz
- 28 VOLTS
- COMMON BASE
- OVERLAY DIE GEOMETRY
- REFRACTORY/GOLD METALLIZATION
- HIGH RELIABILITY AND RUGGEDNESS
- LOW THERMAL RESISTANCE
- $P_{OUT} = 30 \text{ W MIN. WITH } 8.7 \text{ dB GAIN}$


**DESCRIPTION**

The SD1868 is a 28 V internally input and output matched silicon NPN planar transistor designed for 1.6 GHz SATCOM applications. The device utilizes polysilicon site ballasting with gold metallized to achieve high reliability and ruggedness.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	15	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	5.2	A
$P_{DISS}$	Power Dissipation	58.3	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

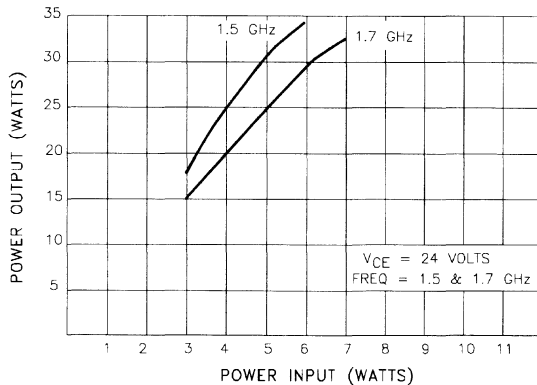
**ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 10\text{mA}$	$I_{\text{E}} = 0\text{mA}$	45	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 10\text{mA}$	$I_{\text{B}} = 0\text{mA}$	10	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 10\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 0.5\text{A}$	15	—	150	—

\* Pulsed through 25MHz Inductor

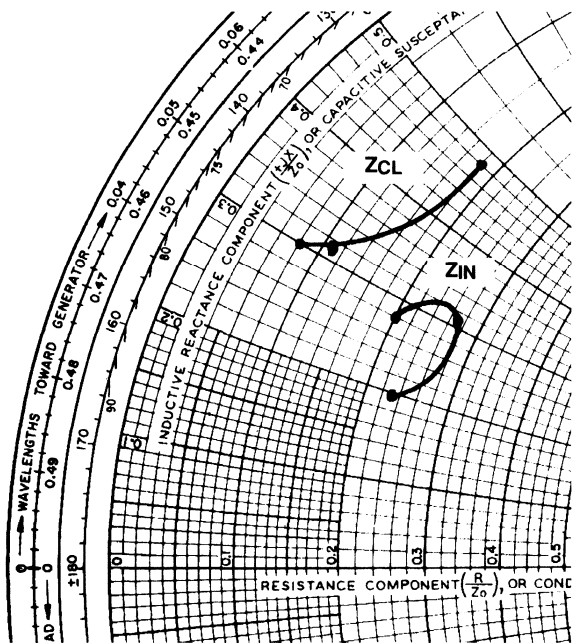
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 1.6 - 1.65 \text{ GHz}$	$P_{\text{IN}} = 4.0 \text{ W}$	$V_{\text{CE}} = 28 \text{ V}$	30	—	—	W
$G_{\text{P}}$	$f = 1.6 - 1.65 \text{ GHz}$	$P_{\text{OUT}} = 30 \text{ W}$	$V_{\text{CE}} = 28 \text{ V}$	8.75	—	—	dB
$\eta_{\text{c}}$	$f = 1.6 - 1.65 \text{ GHz}$	$P_{\text{IN}} = 4.0 \text{ W}$	$V_{\text{CE}} = 28 \text{ V}$	40	—	—	%

**TYPICAL PERFORMANCE****POWER OUTPUT vs POWER INPUT**

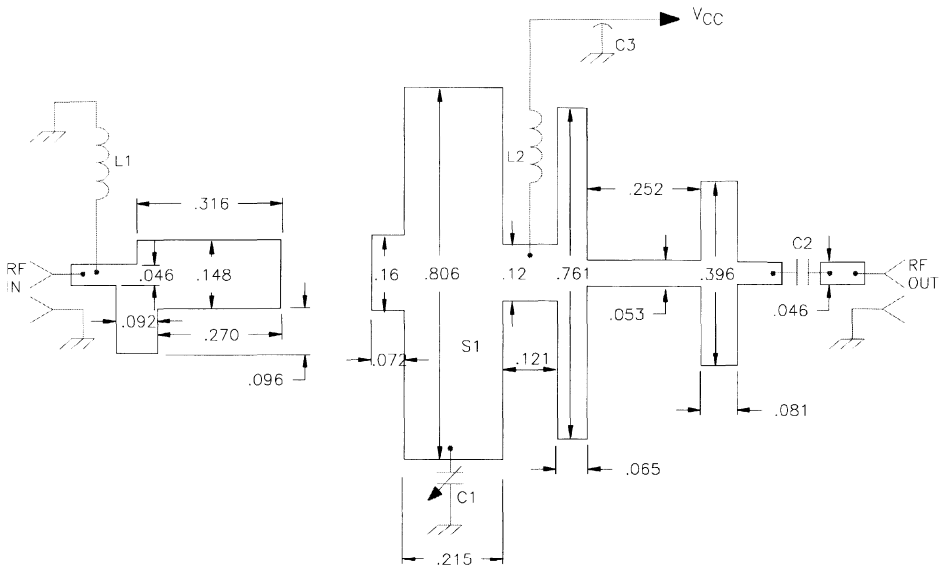


## IMPEDANCE DATA



FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
1.6 GHz	$11.6 + j 10.2$	$9.0 + j 24.2$
1.8 GHz	$13.7 + j 15.5$	$5.4 + j 15.7$
2.0 GHz	$10.2 + j 13.9$	$4.1 + j 14.8$

## TEST CIRCUIT



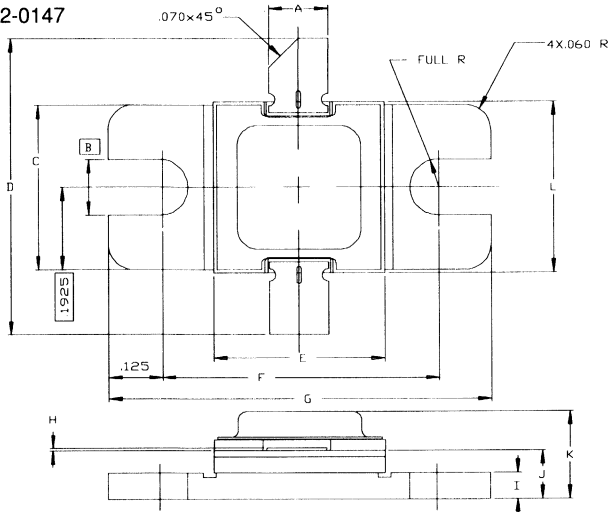
- C1 : .4 - 2.5pF Johanson Capacitor  
 C2 : 100pF Chip Capacitor ATC  
 C3 : 15,000pF EMI Filter Murata/Erie

L1, L2 : 4 Turns, #28 Wire, .080" Diameter

S1 : Epsilon 10, Er = 10.2, Thickness .050"  
 1 Oz. Copper SMA Launcher CDI (2 pieces)  
 .397 Sq. Fixture Housing, Heatsink

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0147

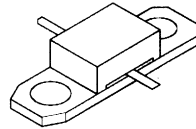


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.135/.343	.145/.368	K		.230/.584
B	.125/.318		L	.392/.996	.405/.10,29
C	.380/.965	.390/.991			
D	.880/.22,35				
E	.392/.996	.405/.10,29			
F	.645/.16,38	.655/.16,64			
G	.895/.22,73	.905/.22,99			
H	.002/.0,05	.006/.0,15			
I	.055/.140	.065/.1,65			
J	.105/.2,67	.125/.3,18			



**RF & MICROWAVE TRANSISTORS**  
**1.6 GHz SATCOM APPLICATIONS**

- 1.65 GHz
- 28 VOLTS
- EFFICIENCY 50% MIN.
- CLASS C OPERATION
- COMMON BASE
- INPUT/OUTPUT MATCHING
- $P_{OUT} = 24 \text{ W MIN. WITH } 9.0 \text{ dB GAIN}$



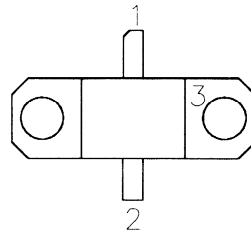
**.250 SQ. 2LFL (M170)**  
 epoxy sealed

**ORDER CODE**  
 SD1888-03

**BRANDING**  
 1888-3

**DESCRIPTION**

The SD1888-03 is a 28 V Class C silicon NPN transistor designed for INMARSAT and other 1.65 GHz SATCOM applications. A gold metallized emitter-ballasted die geometry is employed providing high gain and efficiency while ensuring long term reliability and ruggedness under severe operating conditions. SD1888-03 is packaged in a cost-effective epoxy sealed housing

**PIN CONNECTION**


1. Collector                      3. Base  
 2. Emitter

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	12	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_C$	Device Current	2.6	A
$P_{DISS}$	Power Dissipation	50	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	3.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

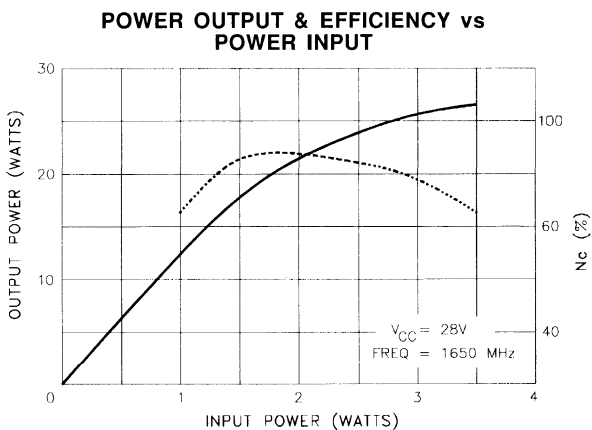
STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 6mA$	$I_E = 0mA$	45	—	—	V
$BV_{CEO}$	$I_C = 6mA$	$I_B = 0mA$	12	—	—	V
$BV_{EBO}$	$I_E = 6mA$	$I_C = 0mA$	3.0	—	—	V
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1.2A$	15	—	150	—

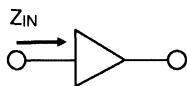
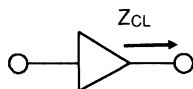
DYNAMIC

Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.65 GHz$	$P_{IN} = 3.0 W$	$V_{CE} = 28 V$	24	—	—	W	
$G_P$	$f = 1.65 GHz$	$P_{IN} = 3.0 W$	$V_{CE} = 28 V$	9.0	—	—	dB	
$\eta_C$	$f = 1.65 GHz$	$P_{IN} = 3.0 W$	$V_{CE} = 28 V$	50	—	—	%	

**TYPICAL PERFORMANCE**

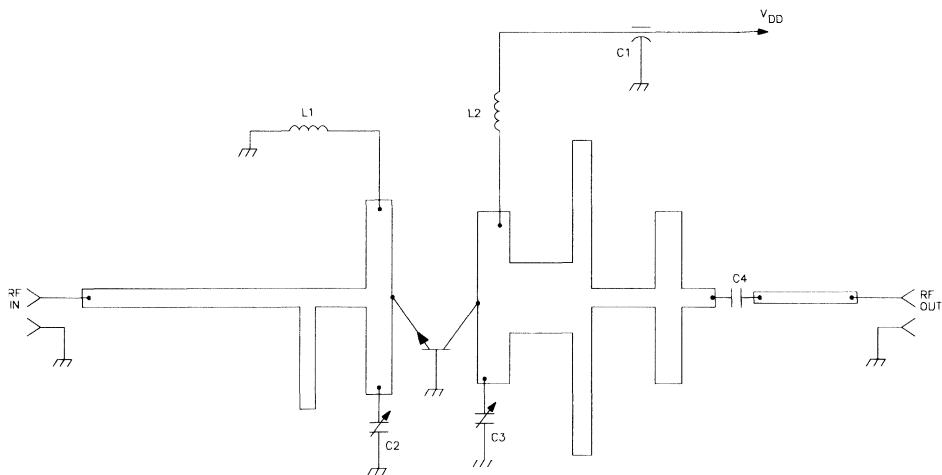


## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1600 MHz	9.0 + j 14.0	11.0 + j 2.0
1650 MHz	11.5 + j 12.0	9.0 + j 4.0
1700 MHz	23.0 + j 8.0	8.0 + j 5.5

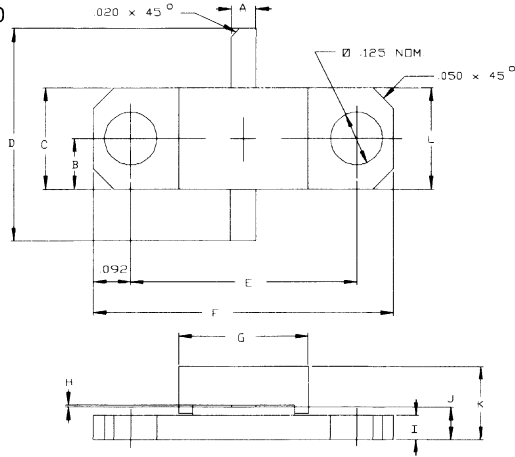
## TEST CIRCUIT



- C1 : 1500pF Feedthru Capacitor Erie  
 C2, C3 : 0.4 - 2.5pF Trim Capacitor Johanson Gigatrim  
 C4 : 100pF ATC Chip Capacitor  
 L1, L2 : RF Chokes; 3 Turns #22 Wire .100" Diameter

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0170

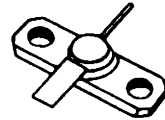


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.055/1,40	.065/1,65			
B	.124/3,15		K	.190/4,83	
C	.243/6,17	.253/6,43	L	.255/6,48	
D	.635/16,13	.665/16,89			
E	.555/14,10	.565/14,35			
F	.739/18,77	.749/19,02			
G	.315/8,00	.325/8,26			
H	.002/0,05	.006/0,15			
I	.055/1,40	.065/1,65			
J	.075/1,91	.095/2,41			



**RF & MICROWAVE TRANSISTORS**  
**1.6 GHz SATCOM APPLICATIONS**

- 1.65 GHz
- 28 VOLTS
- GOLD METALLIZED SYSTEM
- POLYSILICON SITE BALLASTING
- OVERLAY DIE GEOMETRY
- HIGH RELIABILITY AND RUGGEDNESS
- $P_{OUT} = 5.0$  W MIN. WITH 14.0 dB GAIN



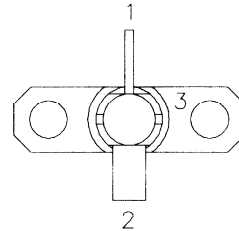
**.230 2LFL (M151)**  
hermetically sealed

**ORDER CODE**  
SD1891-03

**BRANDING**  
1891-03

**DESCRIPTION**

The SD1891-03 is a 28 V silicon NPN transistor designed for INMARSAT and other 1.6 GHz SATCOM applications. This device utilizes polysilicon site ballasting with a gold metallized die to achieve high reliability and ruggedness.

**PIN CONNECTION**


1. Collector                      3. Base  
2. Emitter

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	15	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	1.1	A
$P_{DISS}$	Power Dissipation	8.8	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	20.0	$^{\circ}C/W$
---------------	----------------------------------	------	---------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

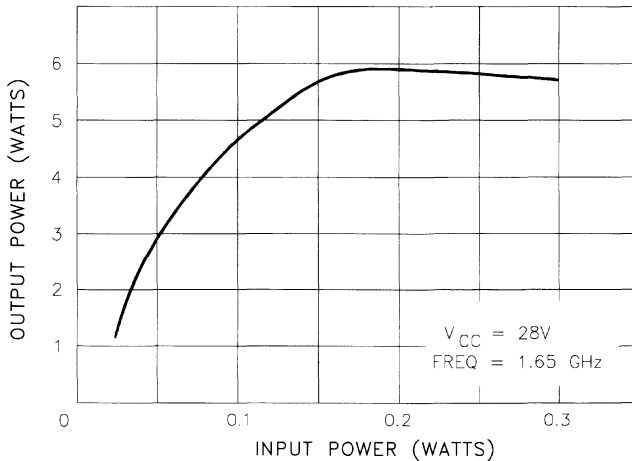
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 1\text{mA}$	$I_{\text{E}} = 0\text{mA}$	45	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 1\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 24\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	0.5	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$	15	—	150	—

## DYNAMIC

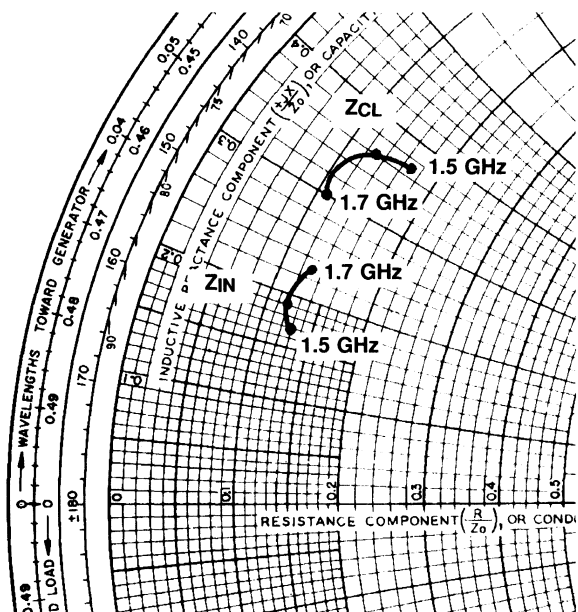
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 1.65\text{ MHz}$	$P_{\text{IN}} = 200\text{ mW}$	$V_{\text{CE}} = 28\text{ V}$	5.0	—	—	W
$G_{\text{P}}$	$f = 1.65\text{ MHz}$	$P_{\text{IN}} = 200\text{ mW}$	$V_{\text{CE}} = 28\text{ V}$	14	—	—	dB
$\eta_{\text{C}}$	$f = 1.65\text{ MHz}$	$P_{\text{IN}} = 200\text{ mW}$	$V_{\text{CE}} = 28\text{ V}$	45	—	—	%
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{ V}$		—	2.5	—	pF

## TYPICAL PERFORMANCE

## POWER OUTPUT vs POWER INPUT

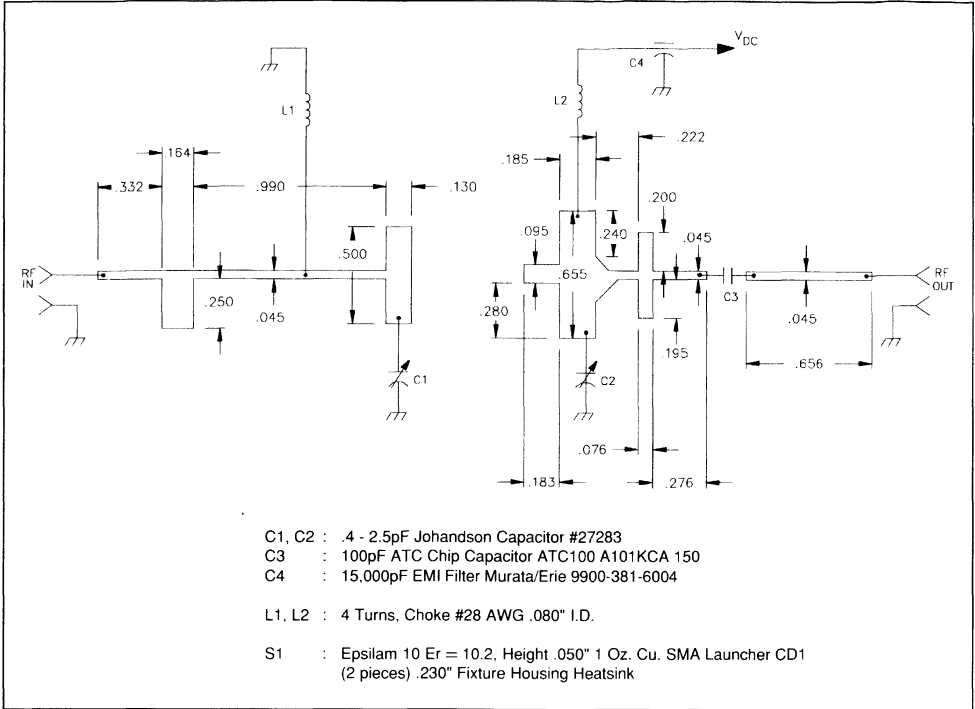


## IMPEDANCE DATA



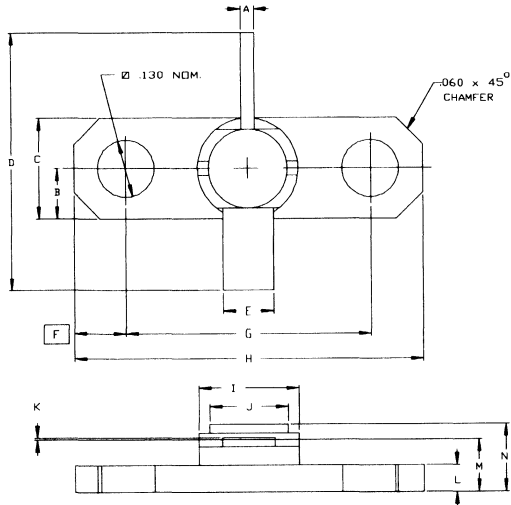
FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1.5 GHz	6.5 + j 8.5	8.5 + j 18.5
1.6 GHz	6.0 + j 9.5	6.5 + j 18.0
1.7 GHz	6.5 + j 11.5	5.5 + j 15.0

## TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0192

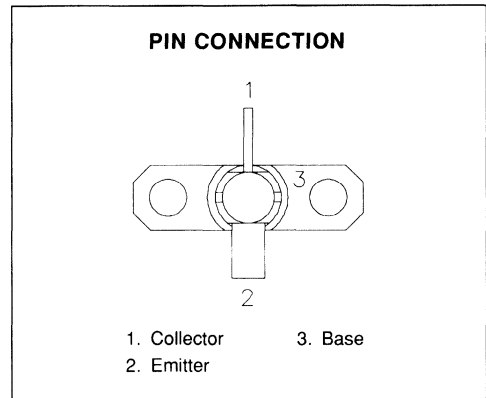
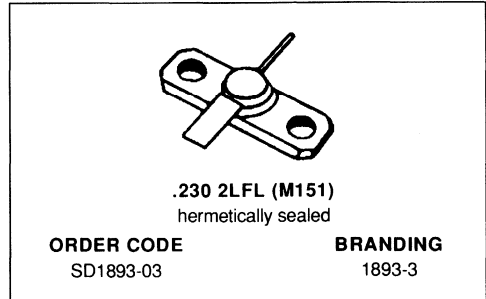


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.025/0,64	.035/0,89	K	.003/0,08	.007/0,18
B	.115/2,92 NDM		L	.055/1,40	.067/1,70
C	.225/5,72	.235/5,97	M	.120/3,18	.140/3,56
D	.710/18,03	.750/19,05	N		.170/4,32
E	.110/2,79	.120/3,05			
F	.120/3,05 NDM				
G	.555/14,10	.565/14,35			
H	.795/20,19	.805/20,45			
I	.222/5,64	.236/5,99			
J	.165/4,19	.185/4,70			



**RF & MICROWAVE TRANSISTORS**  
**1.6 GHZ SATCOM APPLICATIONS**

- 1.65 GHz
- 28 VOLTS
- OVERLAY DIE GEOMETRY
- GOLD METALLIZATION
- HIGH RELIABILITY AND RUGGEDNESS
- $P_{OUT} = 10 \text{ W MIN. WITH } 11.0 \text{ dB GAIN}$
- COMMON BASE


**DESCRIPTION**

The SD1893-03 is a 28 V silicon NPN planar transistor designed for INMARSAT and other 1.6 GHz SATCOM applications. The device utilizes polysilicon site ballasting with a gold metallized die to achieve high reliability and ruggedness.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	15	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	4.4	A
$P_{DISS}$	Power Dissipation	43	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

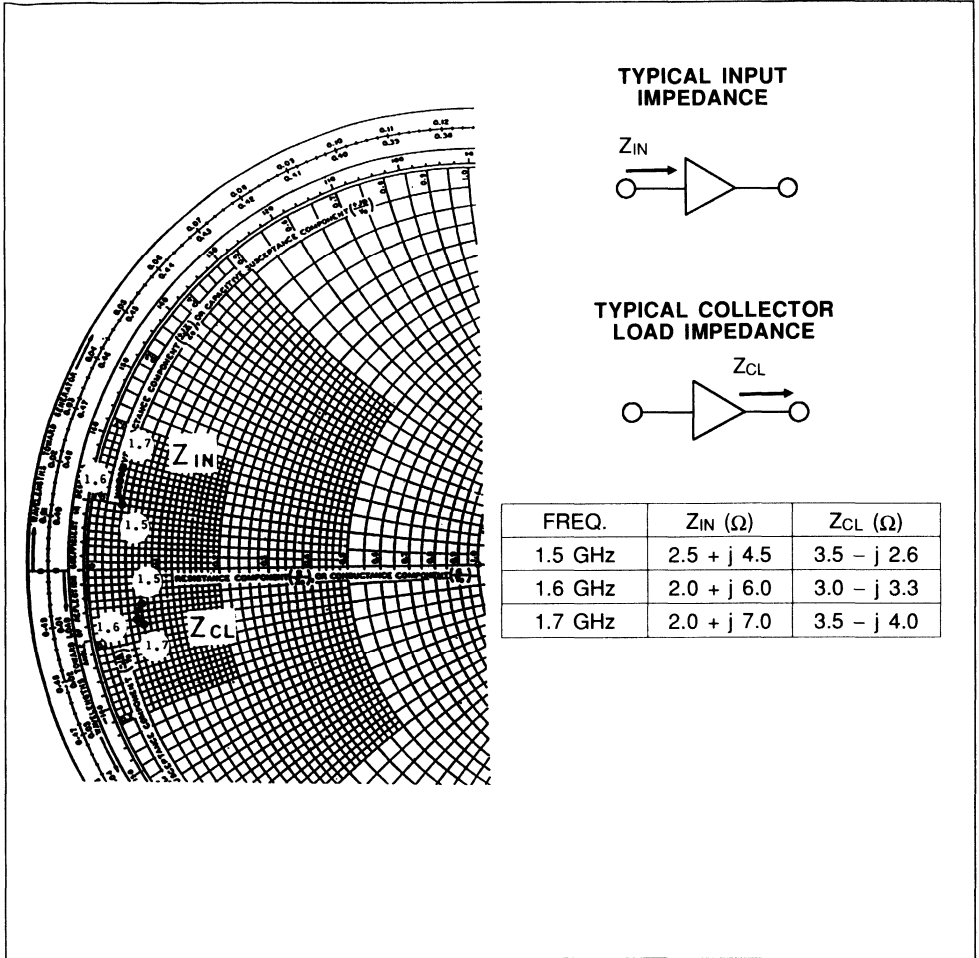
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 3mA$	$I_E = 0mA$	45	—	—	V
$BV_{EBO}$	$I_E = 3mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CBO}$	$V_{CB} = 28V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 300mA$	15	—	150	—

## DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.65 GHz$	$P_{IN} = 0.6 W$	$V_{CE} = 28 V$	10	—	—	W
$G_P$	$f = 1.65 GHz$	$P_{IN} = 0.6 W$	$V_{CE} = 28 V$	11	—	—	dB
$\eta_c$	$f = 1.65 GHz$	$P_{IN} = 0.6 W$	$V_{CE} = 28 V$	45	—	—	%
$C_{OB}$	$f = 1 MHz$	$V_{CB} = 28 V$		—	19	—	pF



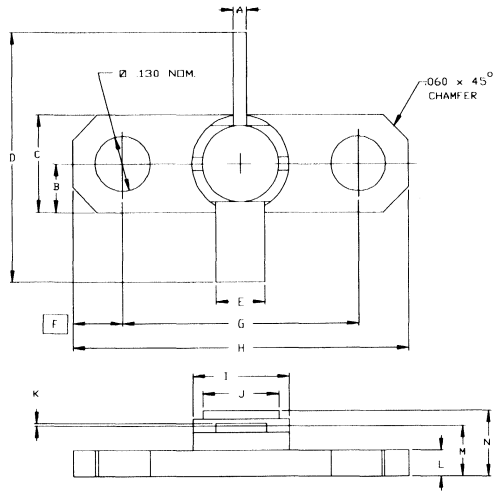
## IMPEDANCE DATA





## PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0192

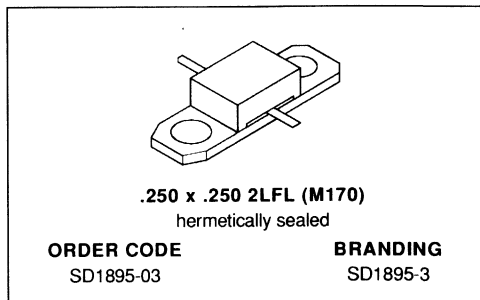


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm	
A	.025/0,64	.035/0,89	K	.003/0,08	.007/0,18
B	.115/2,92 NDM		L	.055/1,40	.067/1,70
C	.225/5,72	.235/5,97	M	.120/3,18	.140/3,56
D	.710/18,03	.750/19,05	N		.170/4,32
E	.110/2,79	.120/3,05			
F	.120/3,05 NDM				
G	.555/14,10	.565/14,35			
H	.795/20,19	.805/20,45			
I	.222/5,64	.236/5,99			
J	.165/4,19	.185/4,70			

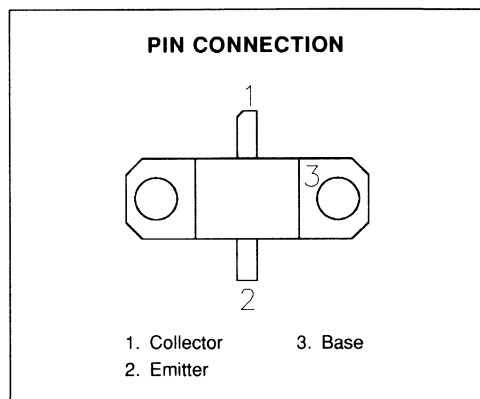


**RF & MICROWAVE TRANSISTORS**  
**1.6 GHz SATCOM APPLICATIONS**

- 1.65 GHz
- 28 VOLTS
- OVERLAY DIE GEOMETRY
- ALL GOLD METALLIZED SYSTEM
- HIGH RELIABILITY AND RUGGEDNESS
- COOMON BASE
- $P_{OUT} = 15 \text{ W MIN. WITH } 9.2 \text{ dB GAIN}$


**DESCRIPTION**

The SD1895-03 is a 28 V silicon NPN planar transistor designed for INMARSAT and other 1.6 GHz SATCOM applications. This device utilizes polysilicon site ballasting with a gold metallized die to achieve high reliability and ruggedness.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	15	V
$V_{EBO}$	Emitter-Base Voltage	3.0	V
$I_C$	Device Current	3.0	A
$P_{DISS}$	Power Dissipation	37.2	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	4.7	$^{\circ}\text{C}/\text{W}$
---------------	----------------------------------	-----	-----------------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

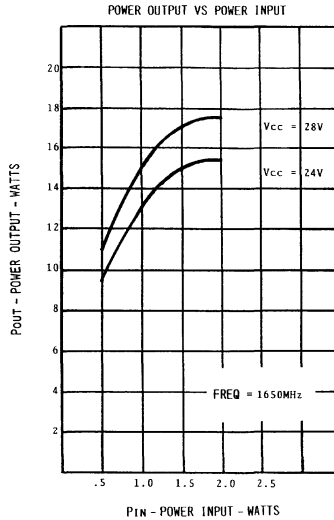
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 5mA$	$I_E = 0mA$	45	—	—	V
$BV_{CEO}$	$I_C = 5mA$	$I_B = 0mA$	12	—	—	V
$BV_{EBO}$	$I_E = 5mA$	$I_C = 0mA$	3.0	—	—	V
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	15	—	150	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.65\text{ GHz}$	$P_{IN} = 2.4\text{ W}$	$V_{CE} = 28\text{ V}$	20	—	—	W
$G_P$	$f = 1.65\text{ GHz}$	$P_{IN} = 2.4\text{ W}$	$V_{CE} = 28\text{ V}$	9.2	—	—	dB
$\eta_C$	$f = 1.65\text{ GHz}$	$P_{IN} = 2.4\text{ W}$	$V_{CE} = 28\text{ V}$	48	—	—	%

**TYPICAL PERFORMANCE**

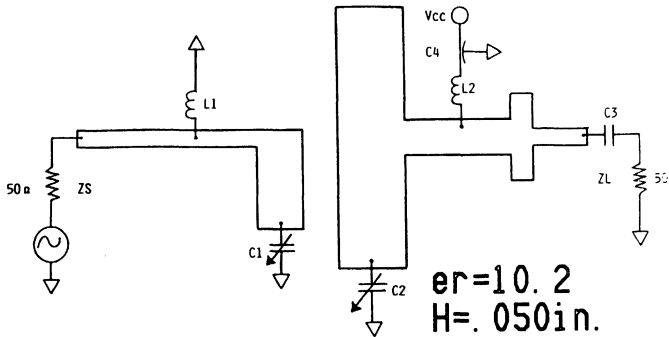
**POWER OUTPUT vs POWER INPUT**



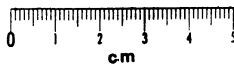
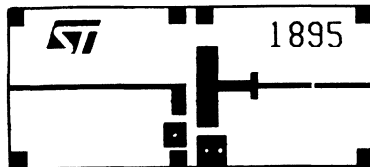
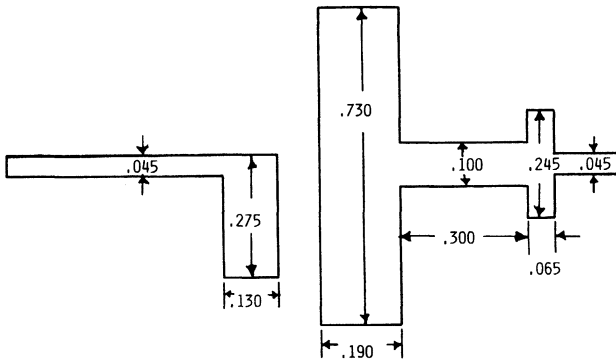
**IMPEDANCE DATA**

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
1.65 GHz	$17.0 + j 18.0$	$3.5 - j 2.0$

## TEST CIRCUIT

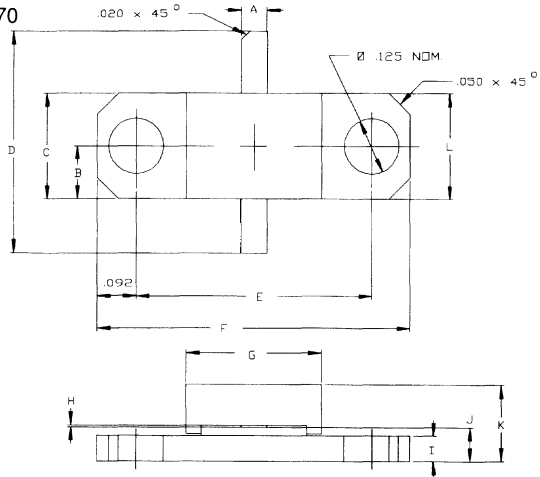


- C1, C2 : 0.4 - 2.5pF #27283 Johanson Trimmer  
 C3 : 100pF ATC 100A101KCA150 Chip Capacitor  
 C4 : 15,000pF EMI Filter Murata/Erie #9900-381-6004  
 L1, L2 : 4 Turns, #28 AWG, .080" I.D.



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0170

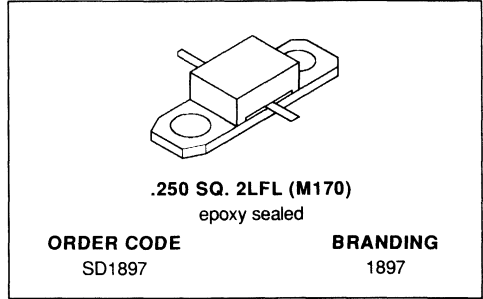


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.055/1,40	.065/1,65	K		.190/4,83
B	.124/3,15		L	.245/6,22	.255/6,48
C	.243/6,17	.253/6,43			
D	.635/16,13	.665/16,89			
E	.555/14,10	.565/14,35			
F	.739/18,77	.749/19,02			
G	.315/8,00	.325/8,26			
H	.002/0,05	.006/0,15			
I	.055/1,40	.065/1,65			
J	.075/1,91	.095/2,41			

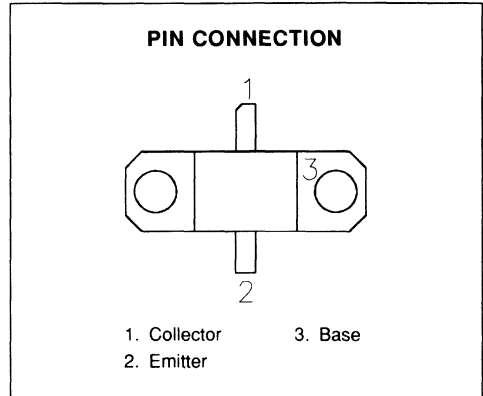


**RF & MICROWAVE TRANSISTORS**  
**1.65 GHz SATCOM APPLICATIONS**

- 1.65 GHz
- 28 VOLTS
- CLASS C OPERATION
- COMMON BASE
- $P_{OUT} = 10 \text{ W MIN. WITH } 11.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1897 is a 28 V Class C silicon NPN transistor designed for INMARSAT and other 1.65 GHz SATCOM applications. A gold metallized emitter-ballasted die geometry is employed providing high gain and efficiency while ensuring long term reliability and ruggedness under severe operating conditions. SD1897 is packaged in a cost-effective epoxy sealed housing.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	15	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	2.3	A
$P_{DISS}$	Power Dissipation	29	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	6.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

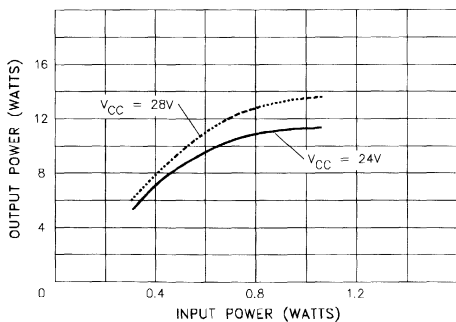
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 3mA$	$I_E = 0mA$	45	—	—	V
$BV_{CEO}$	$I_C = 3mA$	$I_B = 0mA$	12	—	—	V
$BV_{EBO}$	$I_E = 3mA$	$I_C = 0mA$	3.5	—	—	V
$h_{FE}$	$V_{CE} = 5V$	$I_C = 600mA$	15	—	150	—

## DYNAMIC

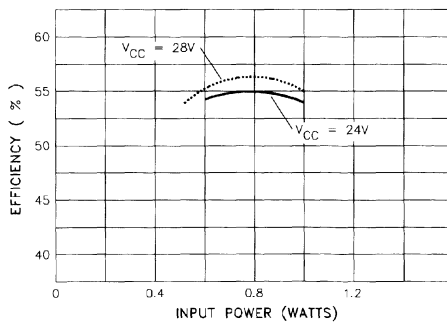
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.65\text{ GHz}$	$P_{IN} = 0.8\text{ W}$	$V_{CE} = 28\text{ V}$	10	—	—	W
$G_P$	$f = 1.65\text{ GHz}$	$P_{IN} = 0.8\text{ W}$	$V_{CE} = 28\text{ V}$	11	—	—	dB
$\eta_C$	$f = 1.65\text{ GHz}$	$P_{IN} = 0.8\text{ W}$	$V_{CE} = 28\text{ V}$	48	—	—	%

## TYPICAL PERFORMANCE

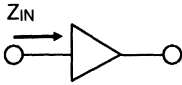
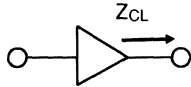
POWER OUTPUT vs POWER INPUT



EFFICIENCY vs POWER INPUT



## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

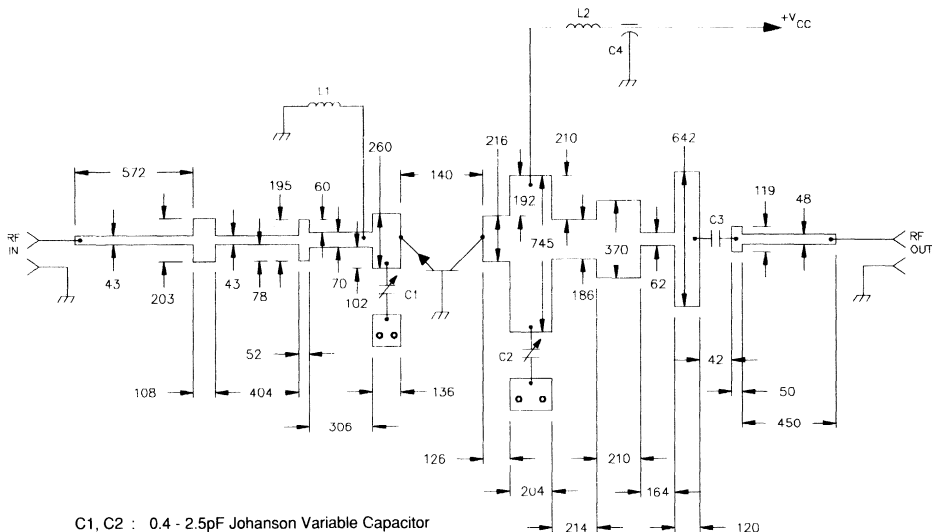
FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
1600 MHz	$22.0 + j 23.0$	$3.1 + j 4.0$
1650 MHz	$28.0 + j 18.0$	$3.0 + j 2.0$

$P_{OUT} = 10 \text{ W}$

$V_{CE} = 28 \text{ V}$

$P_{IN} = 0.8 \text{ W}$

## TEST CIRCUIT



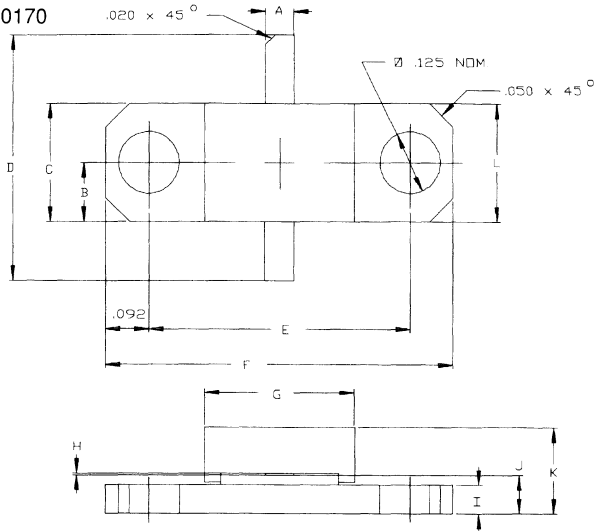
C1, C2 : 0.4 - 2.5pF Johanson Variable Capacitor  
 C3 : 100pF Chip Capacitor ATC  
 C4 : Suppression Filters CDI 9900381-6004

L1, L2 : 4 Turns, Choke #28 AWG .080" I.D.

Substrate: Er = 10.2, Height .050", 1 Oz. Cu.  
 All Dimensions in mm unless otherwise specified

PACKAGE MECHANICAL DATA

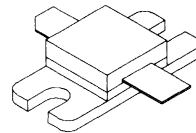
Ref.: Dwg. No.12-0170



SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.055/1,40	.065/1,65	K		190/4,83
B	.124/3,15		L	.245/6,22	.255/6,48
C	.243/6,17	.253/6,43			
D	.635/16,13	.665/16,89			
E	.555/14,10	.565/14,35			
F	.739/18,77	.749/19,02			
G	.315/8,00	.325/8,26			
H	.002/0,05	.006/0,15			
I	.055/1,40	.065/1,65			
J	.075/1,91	.095/2,41			

**RF & MICROWAVE TRANSISTORS**  
**1.6 GHz SATCOM APPLICATIONS**

- 1.65 GHz
- 28 VOLTS
- EFFICIENCY 40% MIN.
- CLASS C OPERATION
- COMMON BASE
- $P_{OUT} = 32 \text{ W MIN. WITH } 9 \text{ dB GAIN}$



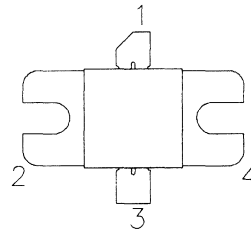
**.400 SQ. 2LFL (M186)**  
 epoxy sealed

**ORDER CODE**  
 SD1898

**BRANDING**  
 1898

**DESCRIPTION**

The SD1898 is a 28 V Class C silicon NPN transistor designed for INMARSAT and other 1.65 GHz SATCOM applications. A gold metallized emitter-ballasted die geometry is employed providing high gain and efficiency while ensuring long term reliability and ruggedness under severe operating conditions. SD1898 is packaged in a cost-effective epoxy sealed housing.

**PIN CONNECTION**


- |              |            |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base      | 4. Base    |

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	45	V
$V_{CEO}$	Collector-Emitter Voltage	15	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	7.8	A
$P_{DISS}$	Power Dissipation	87.5	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

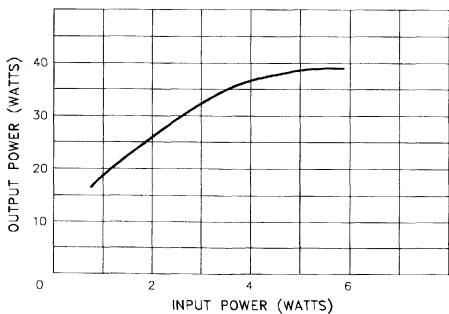
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 10mA$	$I_E = 0mA$	45	—	—	V
$BV_{CEO}$	$I_C = 10mA$	$I_B = 0mA$	12	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$h_{FE}$	$V_{CE} = 5V$	$I_C = 2A$	15	—	150	—

## DYNAMIC

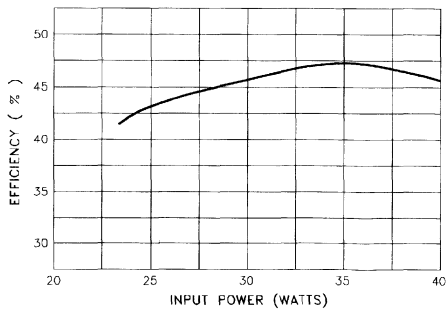
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1.65\text{ GHz}$	$P_{IN} = 4.0\text{ W}$	$V_{CE} = 28\text{ V}$	32	—	—	W
$G_P$	$f = 1.65\text{ GHz}$	$P_{IN} = 4.0\text{ W}$	$V_{CE} = 28\text{ V}$	9.0	—	—	dB
$\eta_c$	$f = 1.65\text{ GHz}$	$P_{IN} = 4.0\text{ W}$	$V_{CE} = 28\text{ V}$	40	—	—	%

## TYPICAL PERFORMANCE

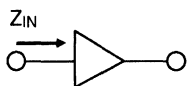
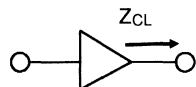
POWER OUTPUT vs POWER INPUT



EFFICIENCY vs POWER INPUT

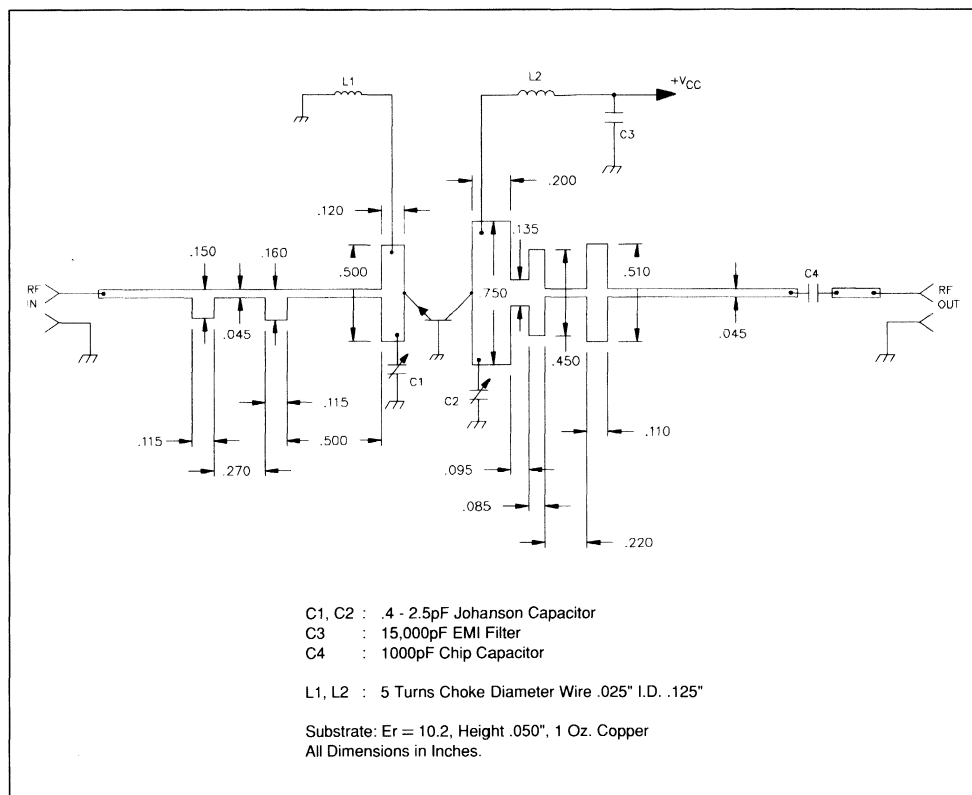


## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

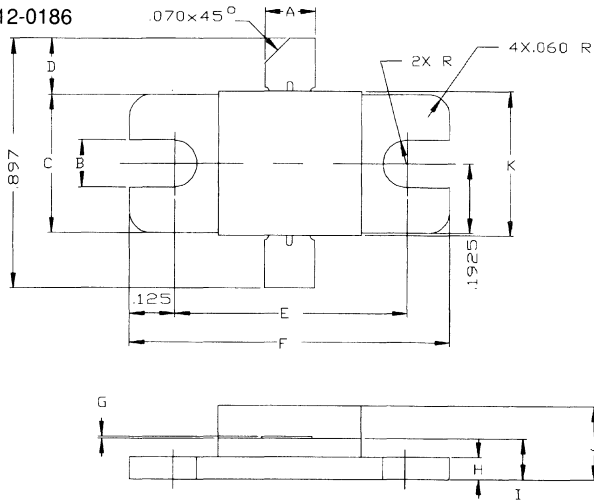
FREQ.	$Z_{IN}$ ( $\Omega$ )	$Z_{CL}$ ( $\Omega$ )
1550 MHz	$6.6 + j 15.0$	$5.6 - j 2.5$
1600 MHz	$8.3 + j 14.5$	$4.7 - j 1.9$
1650 MHz	$12.0 + j 12.0$	$4.1 - j 1.4$

## TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0186

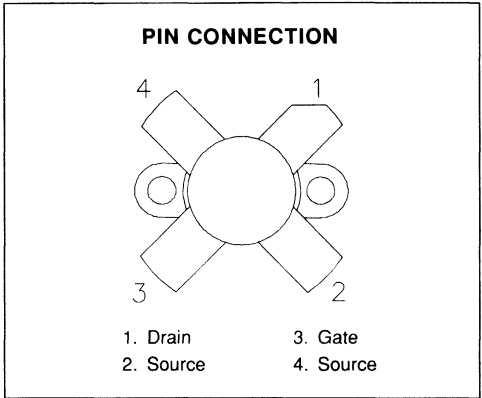
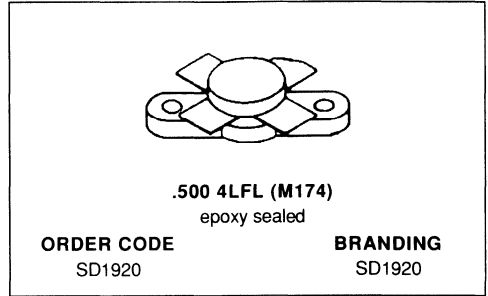


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.135/3,43	.145/3,69	K	.390/9,91	.410/10,41
B	.130/3,30 NDM				
C	.380/ 9,65	.390/ 9,91			
D	.240/6,10	.260/6,61			
E	.645/16,38	.655/16,64			
F	.890/22,61	.910/23,11			
G	.002/0,05	.006/0,15			
H	.055/1,40	.065/1,65			
I	.090/2,29	.110/2,79			
J	.180/4,57	.200/5,08			



**RF MOS FIELD EFFECT TRANSISTORS  
HF/VHF APPLICATIONS**

- 2 - 200 MHz
- 50 VOLTS
- IMD -30 dB
- CLASS AB
- WIDEBAND TUNING
- SIMPLE BIAS CIRCUITRY
- GOLD METALLIZATION FOR HIGH RELIABILITY
- COMMON SOURCE CONFIGURATION
- $P_{OUT} = 150$  W MIN. WITH 8.0 dB GAIN


**DESCRIPTION**

The SD1920 is a gold metallized N-Channel MOS field-effect RF power transistor. The SD1920 is intended for use in 50 V dc large signal applications up to 200 MHz.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{(BR)DSS}$	Drain-Source Voltage	125	V
$V_{DGR}$	Drain-Gate Voltage	125	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Drain Current	13.9	A
$P_{DISS}$	Power Dissipation	215	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.70 (Typ.)	$^{\circ}C/W$
---------------	----------------------------------	-------------	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Parameter		Value			Unit
			Min.	Typ.	Max.	
$V_{(BR)DSS}$	$V_{GS} = 0V$	$I_D = 100mA$	125	—	—	V
$I_{DSS}$	$V_{DS} = 50V$	$V_{GS} = 0V$	—	—	5	mA
$I_{GSS}$	$V_{GS} = 20V$	$V_{DS} = 0V$	—	—	1	$\mu A$
$V_{DS(on)}$	$V_{GS} = 10V$	$I_D = 10A$	—	—	5	V
$G_{FS}$	$V_{DS} = 10V$	$I_D = 5A$	4	—	—	mos
$C_{ISS}$	$V_{DS} = 50V$	$V_{GS} = 0V$	$F = 1MHz$		500	pF
$C_{OSS}$	$V_{DS} = 50V$	$V_{GS} = 0V$	$F = 1MHz$		250	pF
$C_{RSS}$	$V_{DS} = 50V$	$V_{GS} = 0V$	$F = 1MHz$		50	pF
$V_{GS(TH)}$	$V_{GS} = 10V$	$I_D = 100mA$	1	—	5	V

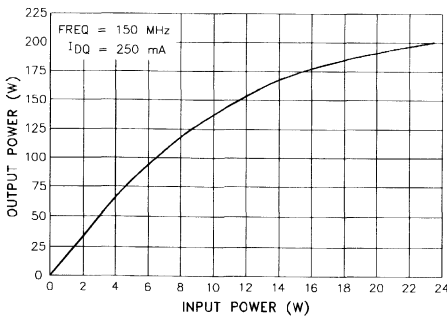
**DYNAMIC**

Symbol	Parameter			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$V_{DS} = 50V$	$I_{DQ} = 250mA$	$f = 150 MHz$	150	—	—	W
$\eta_D$	$V_{DS} = 50V$	$P_{OUT} = 150W$	$I_{DQ} = 250mA$	$f = 150 MHz$	45	—	%
$G_{PS}$	$V_{DS} = 50V$	$P_{OUT} = 150W$	$I_{DQ} = 250mA$	$f = 150 MHz$	8.0	—	dB
$IMD_3^*$	$V_{DS} = 50V$	$P_{OUT} = 150W$	$I_{DQ} = 250mA$	$f = 30 MHz$	—	-30	dB

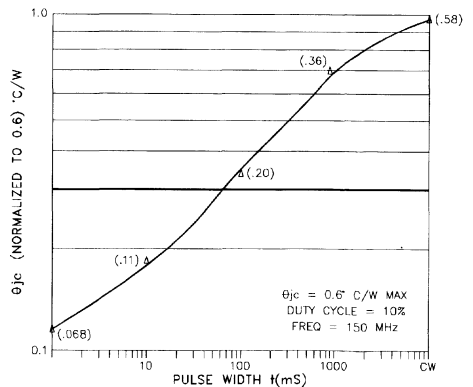
\* 2 Tones,  $\Delta f = 1 kHz$

**TYPICAL PERFORMANCE**

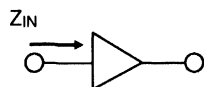
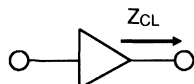
**POWER OUTPUT vs POWER INPUT**



**THERMAL RESPONSE**



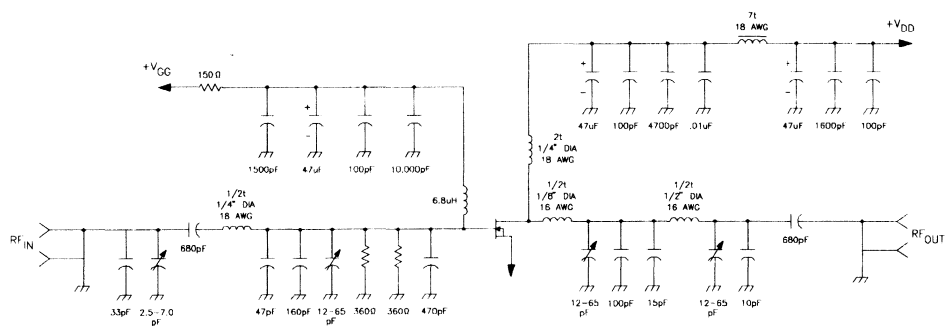
## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
150 MHz	$1.2 - j 1.4$	$2.2 + j 2.3$

## TEST CIRCUIT

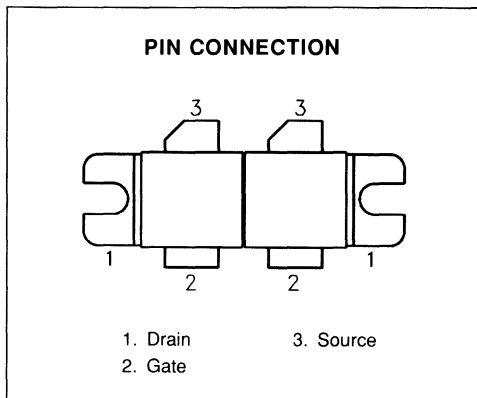
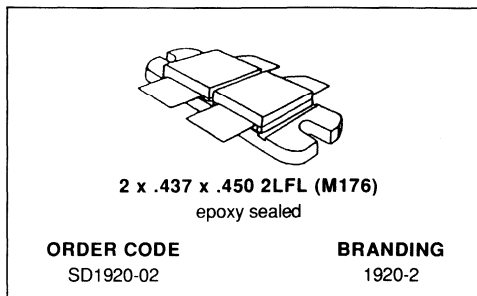
f = 150 MHz





**RF MOS FIELD EFFECT TRANSISTORS**  
**HF/VHF APPLICATIONS**

- 2 - 200 MHz
- 50 VOLTS
- IMD - 30dB
- CLASS AB
- GOLD METALLIZATION FOR HIGH RELIABILITY
- DESIGNED FOR LINEAR OPERATION
- WIDEBAND TUNING
- SIMPLE BIAS CIRCUITRY
- COMMON SOURCE CONFIGURATION
- $P_{OUT} = 300 \text{ W MIN. WITH } 8.0 \text{ dB GAIN}$


**DESCRIPTION**

The SD1920-02 is a gold metallized N-Channel MOS field-effect RF power transistor. The SD1920-02 is intended for used in 50 V dc large signal applications up to 200 MHz.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value (per side)	Unit
$V_{(BR)DSS}$	Drain-Source Voltage	125	V
$V_{DGR}$	Drain-Gate Voltage	125	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Drain Current	13.9	A
$P_{DISS}$	Power Dissipation	215	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.70	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

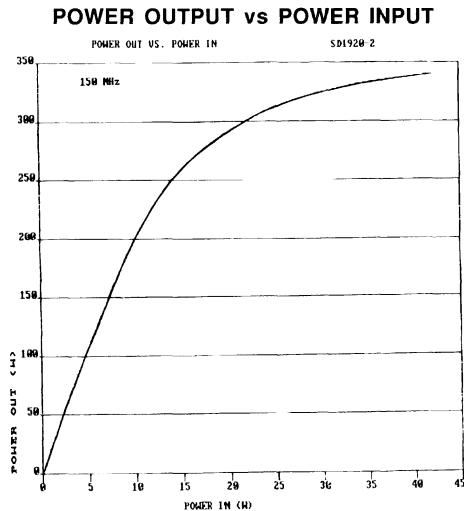
Symbol	Parameter			Value			Unit
				Min.	Typ.	Max.	
$V_{(BR)DSS}$	$V_{GS} = 0V$	$I_D = 100mA$	125	—	—		V
$I_{DSS}$	$V_{DS} = 50V$	$V_{GS} = 0V$	—	—	5		mA
$I_{GSS}$	$V_{GS} = 20V$	$V_{DS} = 0V$	—	—	1		$\mu A$
$V_{DS(on)}$	$V_{GS} = 10V$	$I_D = 10A$	—	—	5		V
$G_{FS}$	$V_{DS} = 10V$	$I_D = 5A$	4	—	—		mos
$C_{ISS}$	$V_{DS} = 50V$	$V_{GS} = 0V$	$F = 1MHz$	—	—	500	pF
$C_{OSS}$	$V_{DS} = 50V$	$V_{GS} = 0V$	$F = 1MHz$	—	—	250	pF
$C_{RSS}$	$V_{DS} = 50V$	$V_{GS} = 0V$	$F = 1MHz$	—	—	50	pF
$V_{GS(TH)}$	$V_{GS} = 10V$	$I_D = 100mA$		1	—	5	V

All DC Static Parameters Tested Per Side.

**DYNAMIC**

Symbol	Parameter			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$V_{DS} = 50 V$	$I_{DQ} = 2 \times 250 mA$	$f = 150 MHz$	300	—	—	W
$\eta_D$	$V_{DS} = 50 V$	$I_{DQ} = 2 \times 250 mA$	$f = 150 MHz$	45	—	—	%
$G_{PS}$	$V_{DS} = 50 V$	$I_{DQ} = 2 \times 250 mA$	$f = 150 MHz$	8.0	—	—	dB

**TYPICAL PERFORMANCE**



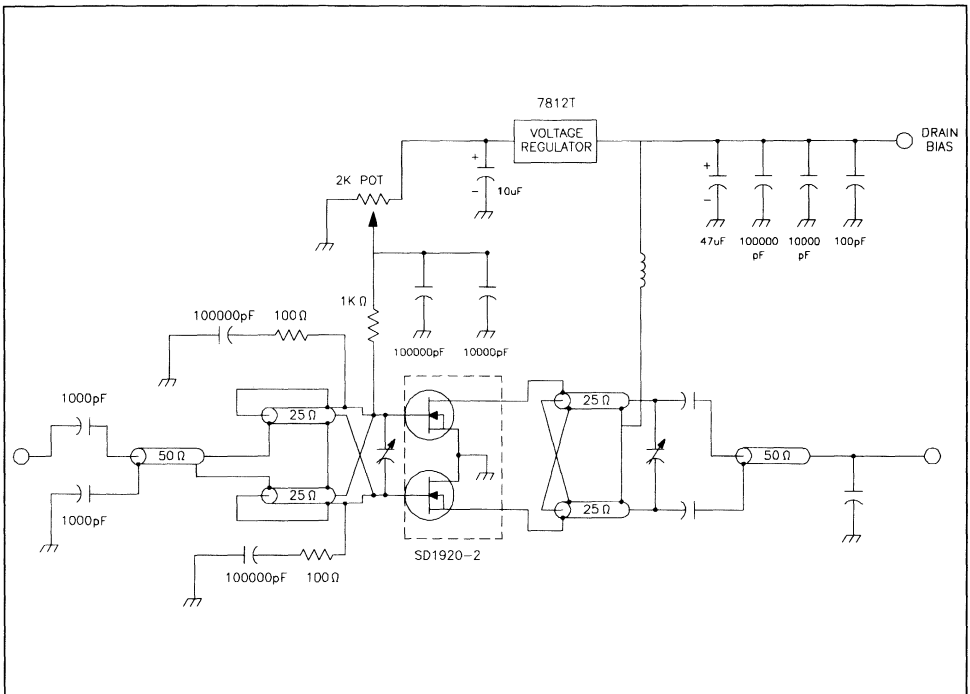
## IMPEDANCE DATA

FREQ.	Z <sub>IN</sub> (Ω)*	Z <sub>CL</sub> (Ω)**
150 MHz	1.2 - j 0.1	3.3 + j 4.7

\* Gate to Gate

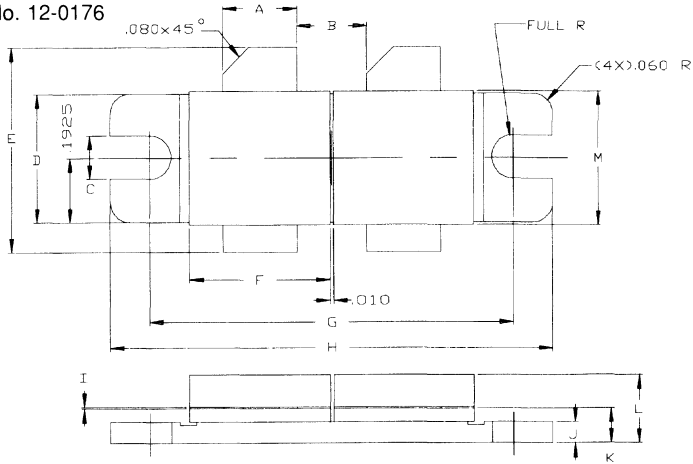
\*\* Drain to Drain

## TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No. 12-0176

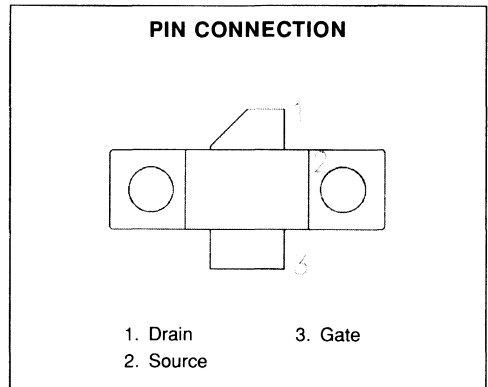
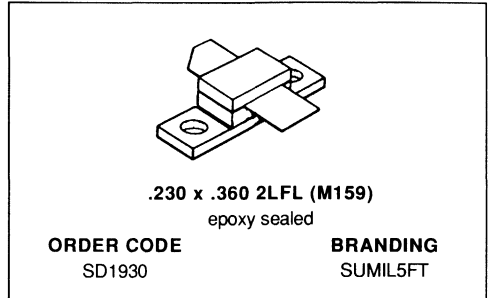


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K	.100/2,54	.115/2,92
B	.210/5,33		L		.230/5,84
C	.125/3,18		M	.395/10,03	.405/10,29
D	.380/9,65	.390/9,91			
E	.580/14,73	.620/15,75			
F	.420/10,67	.430/10,93			
G	1.090/27,69	1.105/28,07			
H	1.335/33,91	1.345/34,16			
I	.003/0,08	.007/0,18			
J	.060/1,52	.070/1,78			



**RF MOS FEILD EFFECT TRANSISTORS  
 HF\VHF BROADBAND APPLICATIONS**

- GOLD METALLIZATION
- NO THERMAL RUNAWAY
- 28 VOLTAGE OUTPUT
- COMMON SOURCE CONFIGURATION
- $P_{OUT} = 5 \text{ W MIN. WITH } 12.0 \text{ dB GAIN}$
- WIDEBAND TUNING
- SIMPLE BIAS CIRCUITRY


**DESCRIPTION**

The SD1930 is a gold metallized N-channel MOS field-effect RF transistor.

The SD1930 is intended for use in 28V DC large signal applications up to 400MHz.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{(BR)DSS}$	Drain-Source Voltage	60	V
$V_{DGR}$	Drain-Gate Voltage	60	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current	.9	A
$P_{DISS}$	Power Dissipation	35	W
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$
$T_{CH}$	Channel Temperature	+200	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

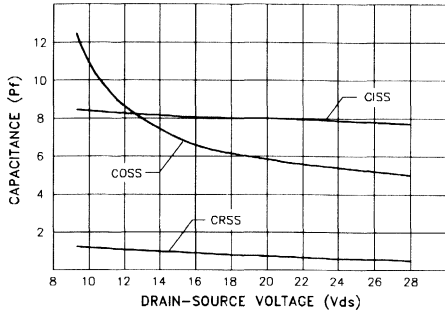
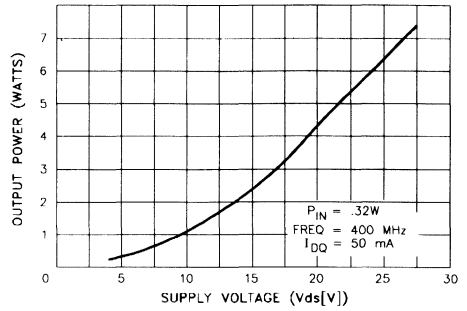
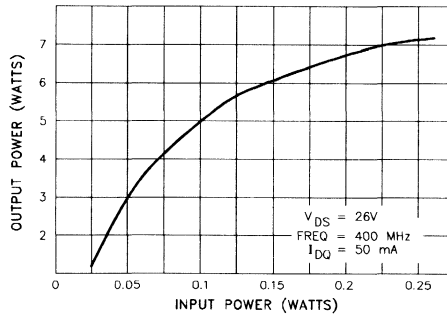
## STATIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}$	$I_{\text{DS}} = 10\text{mA}$		60	—	—	V
$I_{\text{DSS}}$	$V_{\text{GS}} = 0\text{V}$	$V_{\text{DS}} = 28\text{V}$		—	—	1.0	mA
$G_{\text{FS}}$	$V_{\text{DS}} = 10\text{V}$	$I_{\text{D}} = .5\text{A}$		0.2	0.6	—	mho
$C_{\text{ISS}}$	$V_{\text{GS}} = 0\text{V}$	$V_{\text{DS}} = 28\text{V}$	$F = 1\text{MHz}$	—	8	12	pF
$C_{\text{OSS}}$	$V_{\text{GS}} = 0\text{V}$	$V_{\text{DS}} = 28\text{V}$	$F = 1\text{MHz}$	—	5	7	pF
$C_{\text{RSS}}$	$V_{\text{GS}} = 0\text{V}$	$V_{\text{DS}} = 28\text{V}$	$F = 1\text{MHz}$	—	0.6	1.5	pF
$V_{\text{GS}(\text{TH})}$	$V_{\text{DS}} = 10\text{V}$	$I_{\text{D}} = 50\text{mA}$		0.8	—	6.0	V

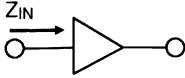
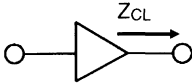
## DYNAMIC

Symbol	Test Conditions				Value			Unit
					Min.	Typ.	Max.	
$P_{\text{OUT}}$	$V_{\text{DD}} = 28\text{V}$	$P_{\text{IN}} = .32\text{W}$	$I_{\text{DQ}} = 50\text{mA}$	$f = 400\text{MHz}$	5.0	7.0	—	W
$\eta_{\text{D}}$	$V_{\text{DD}} = 28\text{V}$	$P_{\text{OUT}} = 5\text{W}$	$I_{\text{DQ}} = 50\text{mA}$	$f = 400\text{MHz}$	45	55	—	%
$G_{\text{PS}}$	$V_{\text{DD}} = 28\text{V}$	$P_{\text{OUT}} = 5\text{W}$	$I_{\text{DQ}} = 50\text{mA}$	$f = 400\text{MHz}$	12.0	13.0	—	dB

## TYPICAL PERFORMANCE

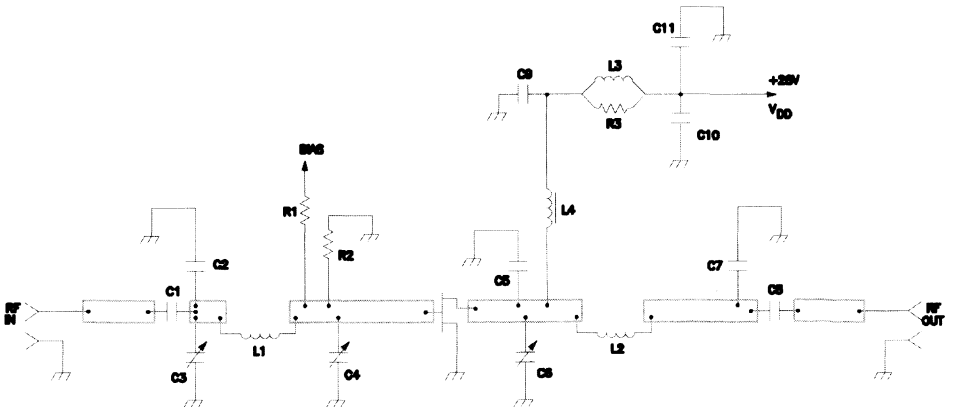
CAPACITANCE vs  
DRAIN-SOURCE VOLTAGEPOWER OUTPUT vs  
SUPPLY VOLTAGEPOWER OUTPUT vs  
POWER INPUT

## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	$Z_{IN} (\Omega)$	$Z_{CL} (\Omega)$
225 MHz	$22.6 - j 12.2$	$33.25 - j 3.52$
400 MHz	$8.5 - j 19.2$	$21.8 + j 21.72$

## TEST CIRCUIT



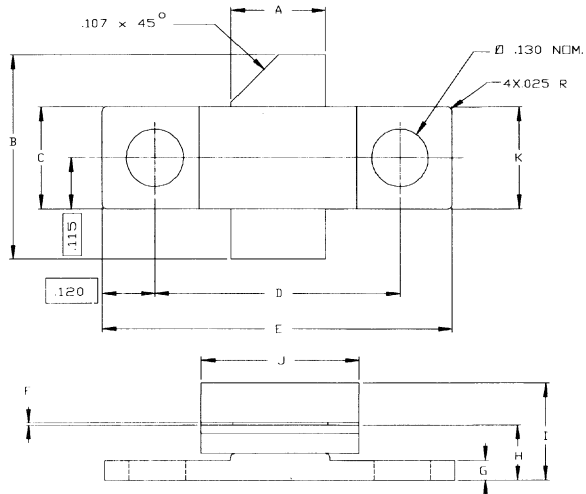
C1, C8 : 470 pF ATC  
 C2, C7 : 17 pF ATC  
 C3, C6 : 8 - 8 pF Johanson  
 C4 : .4 - 2.4 pF Johanson  
 C5 : 9.1 pF ATC  
 C9, C10 : 10  $\mu$ F Electrolytic  
 C11 : .01  $\mu$ F 103K Ceramic

L1, L2 : 0.78 inch long 20 AWG Straight Wire  
 L3 : 7 Turns 20 AWG Wire (0.1 inch diameter)  
 L4 : VK 200 Ferro Cube  
 R1, R2 : 560 Ohm 1/4 Watt  
 R3 : 15 Ohm 1/2 Watt



## PACKAGE MECHANICAL DATA

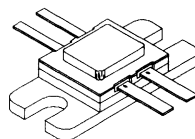
Ref.: Dwg. No. 12-0159



	SGS-THOMSON MICROELECTRONICS		COND	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.210/5,33	.220/5,51	K	.225/5,72
B	.670/17,02	.730/18,54		.235/5,97
C	.225/5,72	.235/5,97		
D	.555/14,10	.565/14,35		
E	.795/20,19	.805/20,45		
F	.003/0,08	.007/0,18		
G	.039/1,00	.050/1,27		
H	.120/3,05	.135/3,43		
I		.240/6,10		
J	.355/9,02	.365/9,27		

**RF & MICROWAVE TRANSISTORS**  
**UHF TV LINEAR APPLICATIONS**

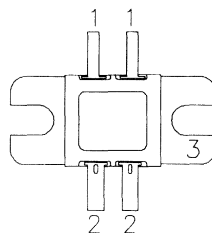
- 470-860 MHz
- 26.5 VOLTS
- GOLD METALLIZATION
- $P_{OUT} = 20.0W$  MIN. WITH 9.5 dB GAIN
- INTERNAL INPUT MATCHING
- DIFFUSED EMITTER BALLAST RESISTORS



**.400 x .425 4LFL (M119)**  
hermetically sealed

**ORDER CODE**  
SD4010

**BRANDING**  
SUTV200

**PIN CONNECTION**


1. Collector                      3. Emitter  
2. Base

**DESCRIPTION**

The SD4010 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors. The SD4010 is intended for use in linear applications up to 1GHz, including UHF television transmitters, transposers and cellular base stations.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60.0	V
$V_{CES}$	Collector-Emitter Voltage	60.0	V
$V_{EBO}$	Emitter-Base Voltage	4.0	V
$I_C$	Device Current (Maximum)	11.0	A
$P_{DISS}$	Power Dissipation	88.8	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	1.9	$^{\circ}C/W$
---------------	----------------------------------	-----	---------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.0	4.0	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	60.0	85.0	—	V
$BV_{CEO}$	$I_C = 50mA$	$I_B = 0mA$	28.0	30.0	—	V
$I_{CEO}$	$V_{CE} = 26.5V$	$I_E = 0mA$	—	—	5	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 3A$	25	50	80	—

Tested Per Side

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 860MHz$	$V_{CE} = 26.5V$	$P_{IN} = 2.2W$	20.0	28.0	—	W
$G_P$	$f = 860MHz$	$V_{CE} = 26.5V$	$P_{OUT} = 20W$	9.5	10.5	—	dB
$IMD_3$	$P_{SYNC} = 20W$	$V_{CE} = 26.5V$	(note 1)	—	-48	-46	dBc
$IP_3$	$V_{CB} = 26.5V$	$P_{OUT} = 20W$	PEP (note 2)	—	55	—	dBm
$COB$	$f = 860MHz$	$V_{CB} = 26.5V$	(note 3)	—	25	36	pF
Load* Mismatch	$f = 860MHz$	$V_{CE} = 26.5V$	$P_{OUT} = 20W$	3:1	10:1	—	VSWR

$I_{CO} = I_C = 2.7A$  (1.35A per Side)

\*VSWR tested for a minimum of 3:1 SWR at all phase angles.

Note 1: Three Tone IMD Testing (CCIR)

$f_1 = 860.0MHz / -8dB$  ref. to  $P_{SYNC}$  - Visual

$f_2 = 863.5MHz / -16dB$  ref. to  $P_{SYNC}$  - Color Subcarrier

$f_3 = 864.5MHz / -7dB$  ref. to  $P_{SYNC}$  - Aural

Note 2:  $IP_3$  Calculated Based on Two-Tone IMD Testing:

$f_1 = 900.0 MHz / -6dB$  ref. to  $P_{OUT}$

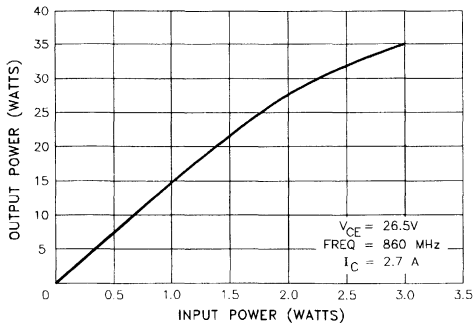
$f_2 = 900.1 MHz / -6dB$  ref. to  $P_{OUT}$

$IMD_3$  (Typ) < -36dBc

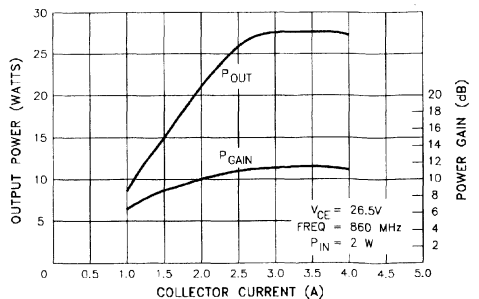
Note 3: Tested Per Side

**TYPICAL PERFORMANCE**

**POWER OUTPUT vs POWER INPUT**



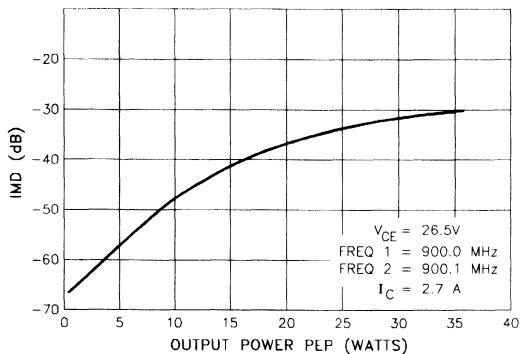
**POWER OUTPUT & POWER GAIN vs TOTAL COLLECTOR CURRENT**



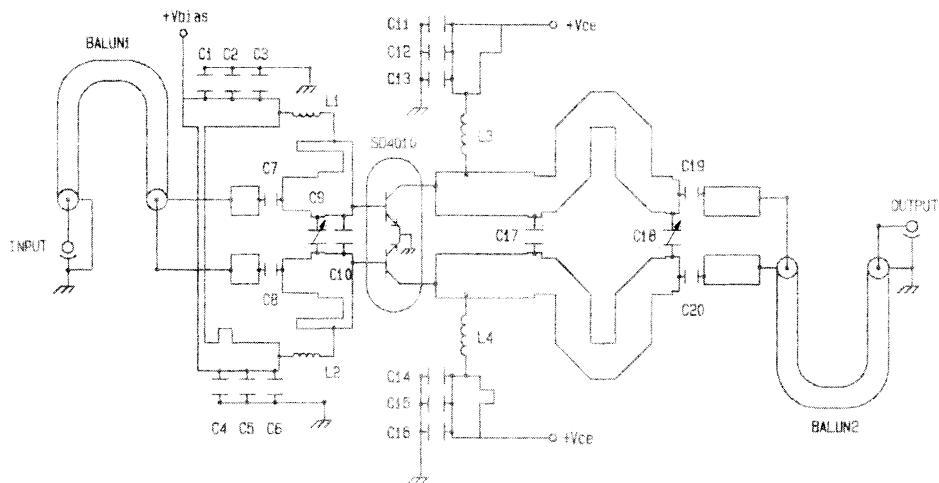


## TYPICAL PERFORMANCE (cont'd)

## INTERMODULATION DISTORTION vs POWER OUTPUT



## TEST CIRCUIT SCHEMATIC



Balun 1, 2 :  $50\Omega$  Coaxial Cable,  $\lambda/4$  @ 860 MHz

C1, C4,  
 C11, C16 :  $100\mu F$ , 50V Electrolytic  
 C2, C5,  
 C12, C15 :  $10\mu F$ , 35V Tantalum  
 C3, C6, C7, C8,  
 C19, C20 : 75 pF Ceramic Chip, ATC B  
 C9, C18 : 0.4 - 2.5 pF Variable, JOHANSON Giga-trim  
 C10 : 2pF Ceramic Chip, ATC B  
 C17 : 5pF Ceramic Chip, ATC B

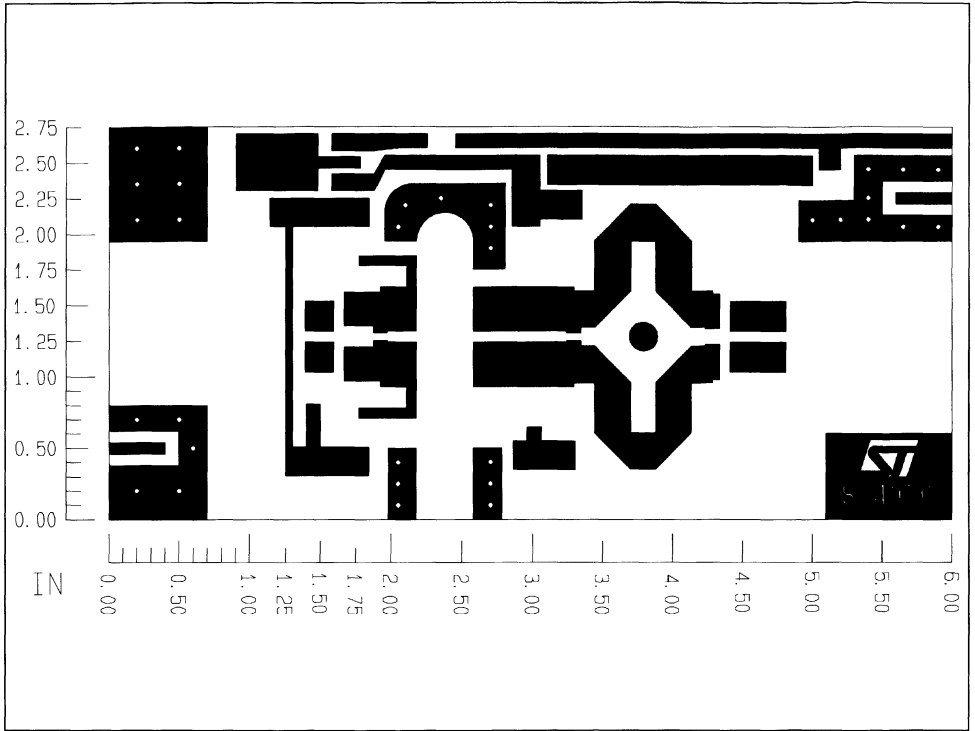
L1, L2 : 7 Turns, 0.12" I.D., #22 AWG (1:1)

L3, L4 : 5 Turns, 0.12" I.D., #22 AWG (1:1)

See Photomaster for Microstrip Lines

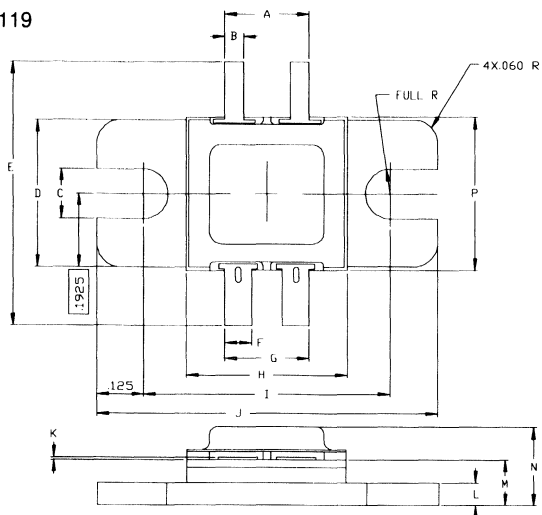
Board  
 Material: ROGERS Ultra-Lam Er = 2.55, Height = 0.030",  
 2 oz. Cu.

PHOTOMASTER OF TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref. Dwg. No.: 12-0119

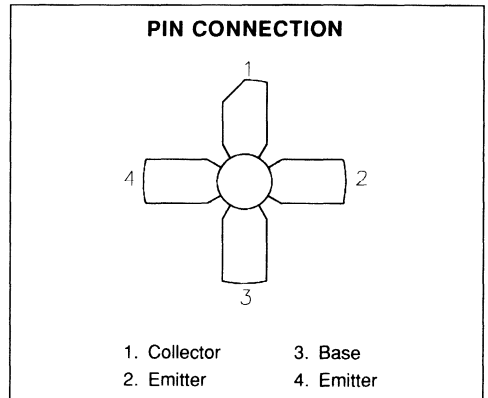
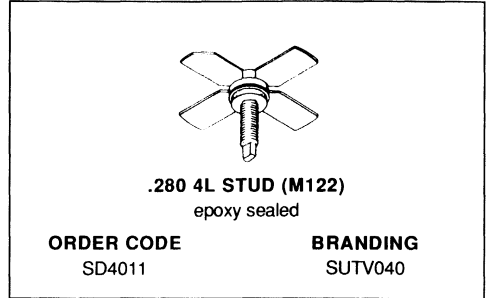


SGS-THOMSON MICROELECTRONICS		CONT'D			
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.210/5,33	.230/5,84	K	.002/0,05	.006/0,15
B	.045/1,14	.055/1,40	L	.058/1,47	.065/1,65
C	130/3,30		M	.115/2,92	.130/3,30
D	.380/9,65	.390/9,91	N	---	.230/5,84
E	.770/19,56	.830/21,08	P	.395/10,03	.408/10,36
F	.070/1,78	.080/2,03			
G	.215/5,46	.235/5,97			
H	.420/10,67	.433/11,00			
I	.645/16,38	.655/16,64			
J	.895/22,73	.905/22,99			



**RF & MICROWAVE TRANSISTORS**  
**UHF TV/LINEAR APPLICATIONS**

- GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- COMMON EMITTER
- OVERLAY GEOMETRY
- CLASS A OPERATION
- METAL/CERAMIC PACKAGE
- $P_{OUT} = 4\text{ W MIN. WITH } 8\text{ dB GAIN}$


**DESCRIPTION**

The SD4011 is a gold metallized NPN silicon bipolar device optimized for Class A operation in TV Band IV/V.

Suitable for a variety of other UHF linear applications, SD4011 is supplied in an industry-standard .280 stud package.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CES}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	1.59	A
$P_{DISS}$	Power Dissipation	31.8	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

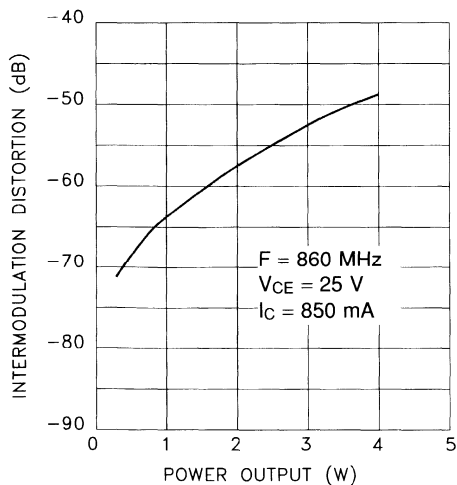
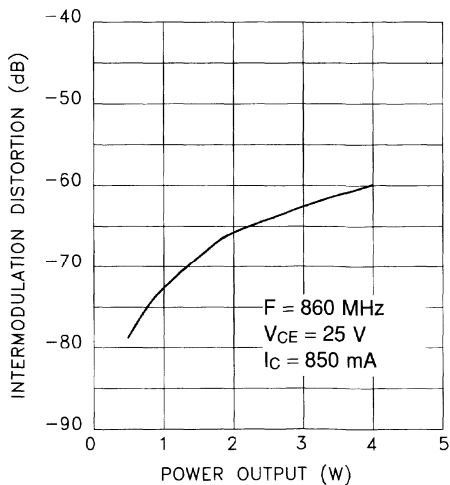
$R_{TH(j-c)}$	Junction-Case Thermal Resistance	5.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

**ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )**STATIC**

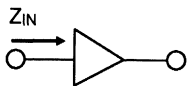
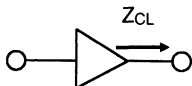
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 5\text{mA}$	$I_{\text{E}} = 0\text{mA}$	65	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 5\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 10\text{mA}$	$V_{\text{BE}} = 0\text{V}$	65	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 5\text{mA}$	$I_{\text{B}} = 0\text{mA}$	20	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 40\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	1.0	mA
$h_{\text{FE}}$	$V_{\text{C}} = 5\text{V}$	$I_{\text{C}} = 800\text{mA}$	20	—	200	—

**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$I_{\text{C}} = 850\text{ mA}$	4	—	—	W
$G_{\text{P}}$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$I_{\text{C}} = 850\text{ mA}$	8.0	—	—	dB
$\text{IMD}_3$	$f = 860\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$	$I_{\text{C}} = 850\text{ mA}$	-60	—	—	dBc
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CE}} = 25\text{ V}$		—	13	20	pF

Note:  $P_{\text{IN}} = 0.63$ **TYPICAL PERFORMANCE****INTERMODULATION DISTORTION  
vs POWER OUTPUT****INTERMODULATION DISTORTION  
(3 TONES) vs POWER OUTPUT**

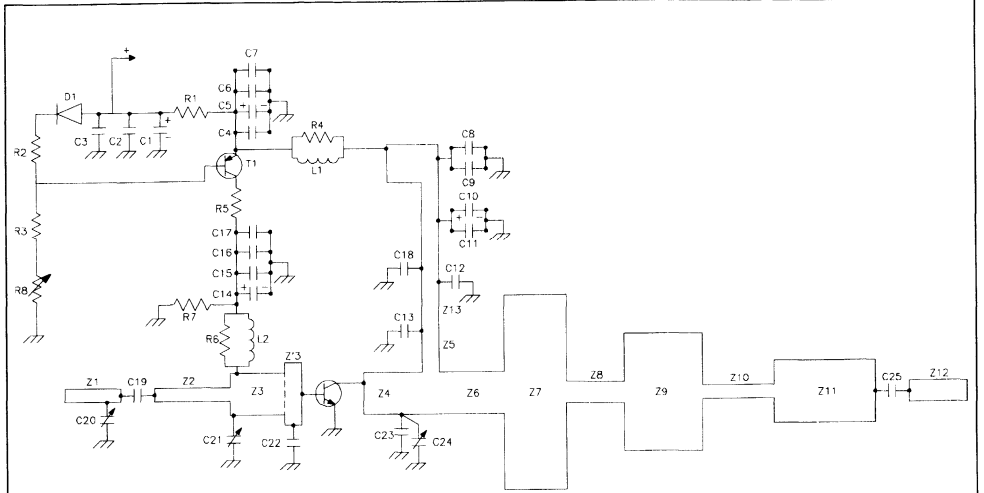
## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
470 MHz	2.26 + j 1.67	11.30 + j 5.23
600 MHz	1.93 + j 1.96	10.65 + j 2.91
700 MHz	1.40 + j 2.38	8.41 + j 6.07
860 MHz	1.19 + j 3.45	5.63 + j 4.17

Normalized to 50 ohms

## TEST CIRCUIT



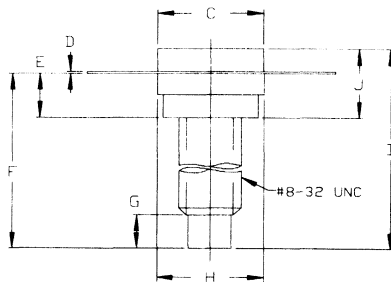
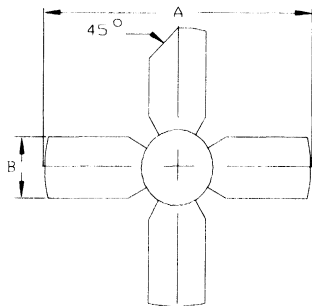
C1	: 22 $\mu$ F - 63V - Sprague	C22	: 10pF ATC 100A
C2, C6,		C23	: 15pF ATC 100B
C8, C15	: 4.7nF Chip LCC	D1	: 1N 4001 or 1N 914
C3, C7, C9		L1	: 6 Turns - Wire Dia. 5/10 on 2.5mm Internal Dia.
C11, C16	: 100nF Chip LCC	L2	: 10 to 12 Turns on R6 - Wire Dia. 5/10
C4, C10	: 4.7 $\mu$ F - 40V - Sprague	R1	: 2.2 $\Omega$ - 3W - Sfernice
C5, C14	: 4.7 $\mu$ F - 63V - Sprague	R2	: 100 $\Omega$ - 1/2W
C12, C17,		R3	: 510 $\Omega$ - 1/2W
C18	: 470pF Chip LCC	R4, R6	: 100 $\Omega$ - 1/2W
C13, C25	: 47pF ATC 100B	R5, R7	: 56 $\Omega$ - 1W
C19	: 47pF ATC 100A	R8	: 3.3k $\Omega$ Adjustable
C20	: 0.5 - 4.5pF Adjustable Airtronic	T1	: BDX 54 B
C21, C24	: 0.8 - 5pF Adjustable Johanson		
Z1	: 50 $\Omega$ transmission line - length 18mm		
Z2	: 50 $\Omega$ transmission line - length 22mm		
Z3	: 16.4 $\Omega$ transmission line - length 12mm		
Z3	: 10.5 $\Omega$ transmission line - length 3.5mm		
Z4	: 20 $\Omega$ transmission line - length 13mm		
Z5	: 50 $\Omega$ transmission line - length 2.5mm		
Z6	: 20 $\Omega$ transmission line - length 23mm		
Z7	: 4 $\Omega$ transmission line - length 8% $\lambda$ g at 860MHz		
Z8	: 55 $\Omega$ transmission line - length 7.5% $\lambda$ g at 860MHz		
Z9	: 7.5 $\Omega$ transmission line - length 8% $\lambda$ g at 860MHz		
Z10	: 100 $\Omega$ transmission line - length 8% $\lambda$ g at 860MHz		
Z11	: 20 $\Omega$ transmission line - length 8% $\lambda$ g at 860MHz		
Z12	: 50 $\Omega$ transmission line - length 5mm		
Z13	: 50 $\Omega$ transmission line - length 12mm		



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No. 12-0122

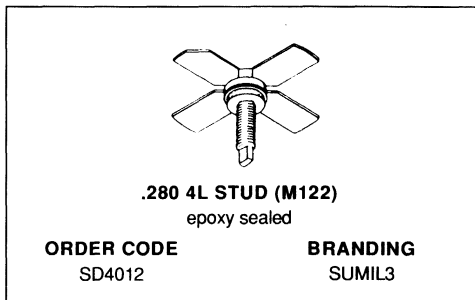
SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51





## RF & MICROWAVE TRANSISTORS UHF COMMUNICATIONS APPLICATIONS

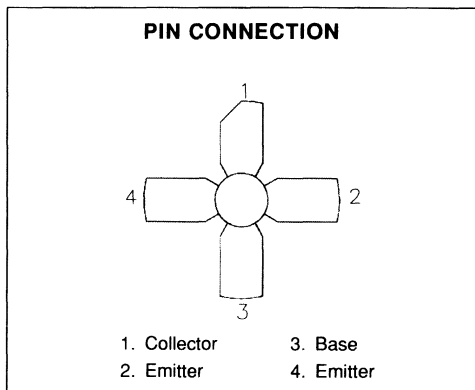
- REFRACTORY/GOLD METALLIZATION
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC PACKAGE
- $P_{OUT} = 3 \text{ W MIN. WITH } 11.7 \text{ dB GAIN}$



### DESCRIPTION

The SD4012 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for superior ruggedness. The SD4012 can withstand a 30:1 VSWR.

Ideal for military communications applications in the 225 - 400 MHz frequency range, the SD4012 provides typically 13 dB gain with 60% collector efficiency.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	55.0	V
$V_{CEO}$	Collector-Emitter Voltage	30.0	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_c$	Device Current	0.7	A
$P_{DISS}$	Power Dissipation	11.0	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	16.0	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

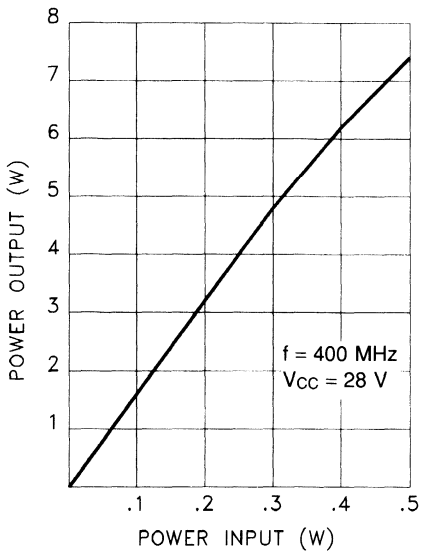
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 20\text{mA}$	$I_{\text{E}} = 0\text{mA}$		55	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 5\text{mA}$	$I_{\text{C}} = 0\text{mA}$		3.5	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 20\text{mA}$	$V_{\text{BE}} = 0\text{V}$		55	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{B}} = 0\text{mA}$		30	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$		—	—	1	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 100\text{mA}$		10	40	150	—

## DYNAMIC

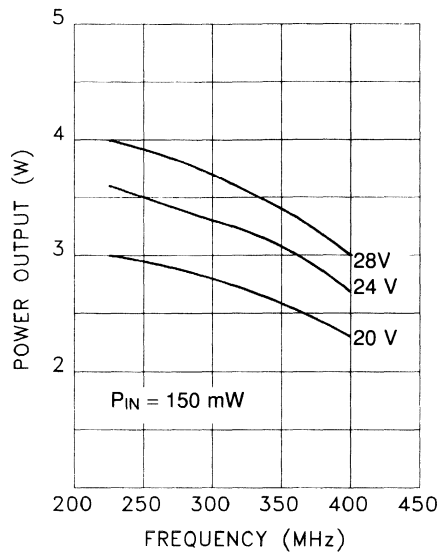
Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 400\text{ MHz}$	$P_{\text{IN}} = 0.2\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	3.0	—	—	W
$P_{\text{IN}}$	$f = 400\text{ MHz}$	$P_{\text{IN}} = 0.2\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	—	—	0.2	W
$\eta_{\text{C}}$	$f = 400\text{ MHz}$	$P_{\text{IN}} = 0.2\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	—	60	—	%
$G_{\text{P}}$	$f = 400\text{ MHz}$	$P_{\text{IN}} = 0.2\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	11.7	13.0	—	dB
VSWR	$f = 400\text{ MHz}$	$P_{\text{IN}} = 0.2\text{ W}$	$V_{\text{CC}} = 28\text{ V}$	—	—	30:1	W
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{V}$		—	4.5	6	W

## TYPICAL PERFORMANCE

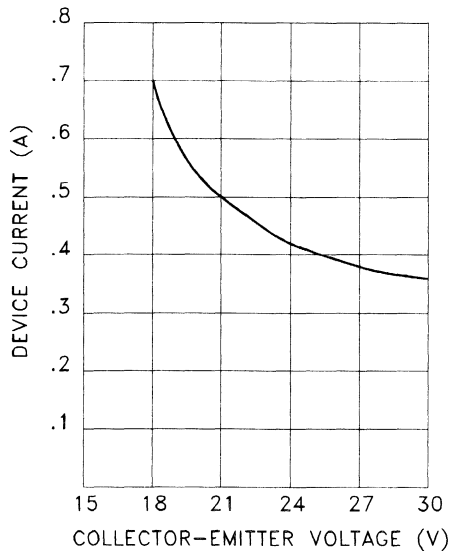
POWER OUTPUT vs POWER INPUT



POWER OUTPUT vs FREQUENCY

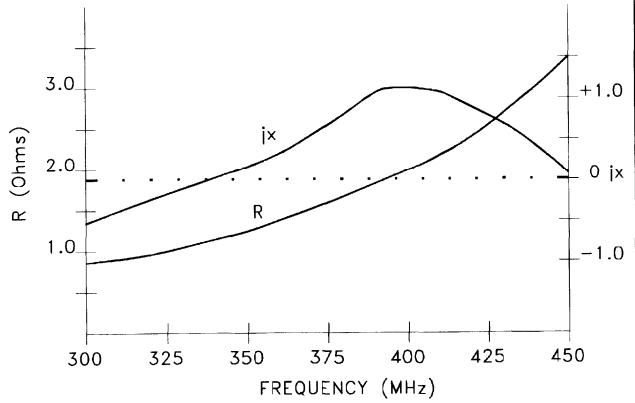
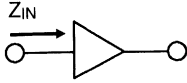


DC SAFE OPERATING AREA

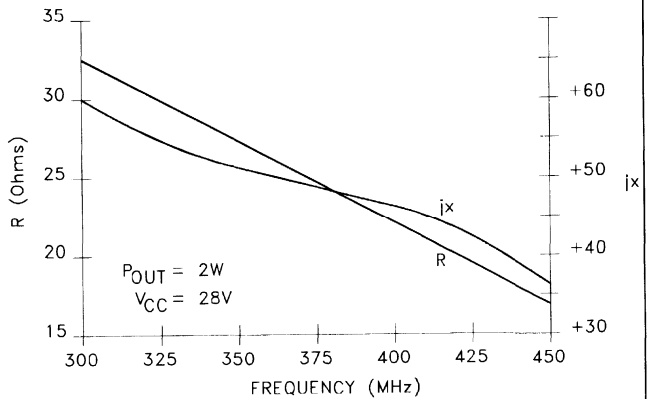
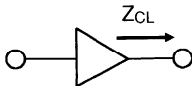


IMPEDANCE DATA

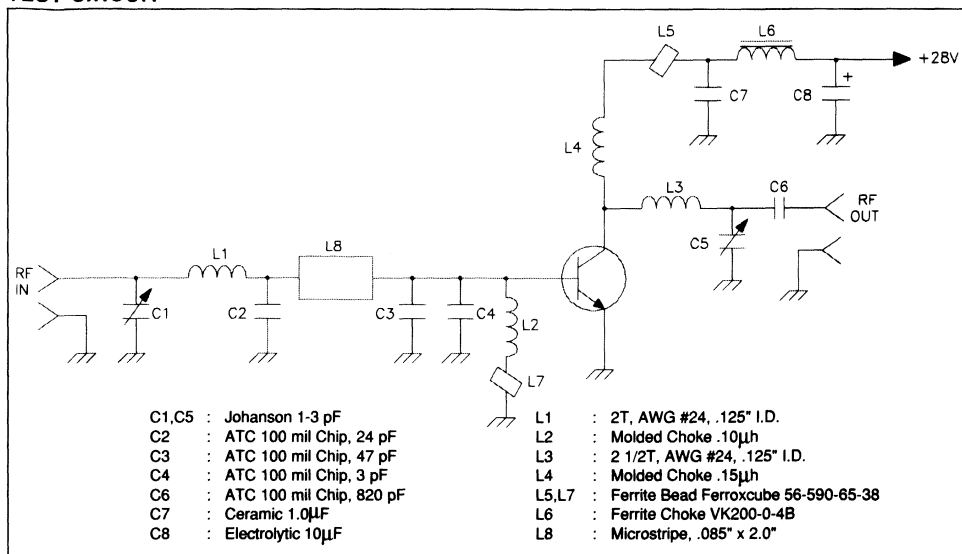
TYPICAL INPUT IMPEDANCE



TYPICAL COLLECTOR LOAD IMPEDANCE



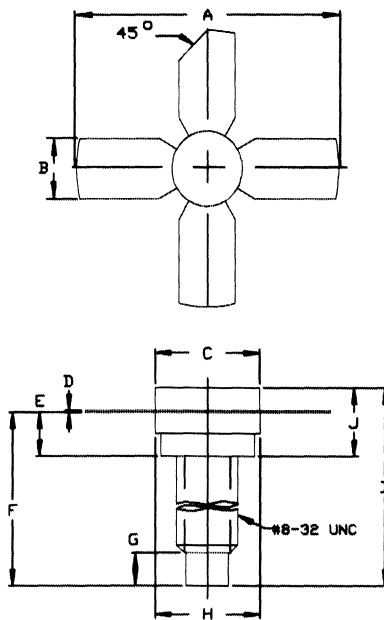
## TEST CIRCUIT



## PACKAGE MECHANICAL DATA

Ref.: Dwg. No. 12-0122

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25.65	1.055/26.80
B	.220/5.59	.230/5.84
C	.270/6.86	.285/7.24
D	.003/0.08	.007/0.18
E	.117/2.97	.137/3.48
F	.572/14.53	
G	.130/3.30	
H	.275/6.99	.285/7.24
J	.640/16.26	
J	.175/4.45	.217/5.51



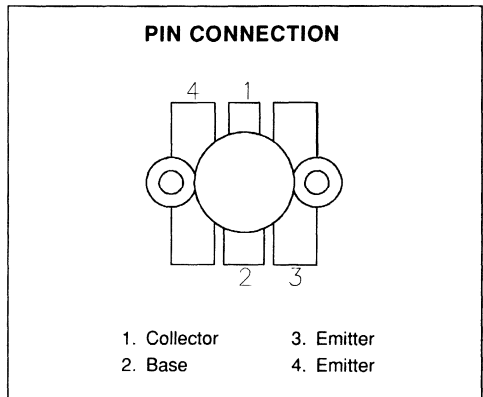
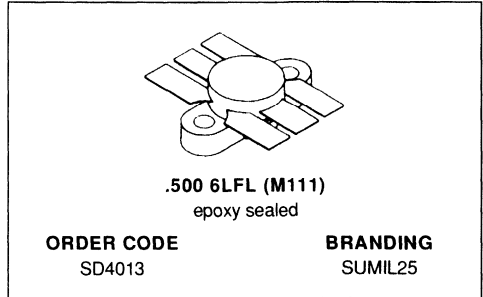




## RF & MICROWAVE TRANSISTORS UHF COMMUNICATIONS APPLICATIONS

PRELIMINARY DATA

- REFRACTORY/GOLD METALLIZATION
- INTERNAL INPUT MATCHING
- METAL/CERAMIC PACKAGE
- EMITTER BALLASTED
- 20:1 VSWR CAPABILITY
- $P_{OUT} = 25 \text{ W MIN. WITH } 9 \text{ dB GAIN}$



### DESCRIPTION

The SD4013 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for superior ruggedness.

The SD4013 can withstand 20:1 VSWR under rated operating conditions and is internally input matched to optimize power gain and efficiency over the band.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{CEO}$	Collector-Emitter Voltage	30	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	3.0	A
$P_{DISS}$	Power Dissipation	70	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.5	$^{\circ}\text{C/W}$
---------------	----------------------------------	-----	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{\text{case}} = 25^{\circ}\text{C}$ )

## STATIC

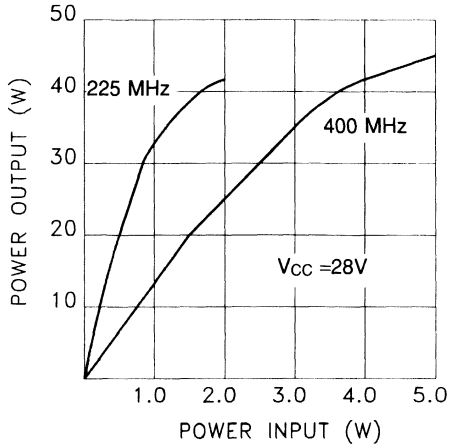
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 50\text{mA}$	$I_{\text{E}} = 0\text{mA}$	60	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 5\text{mA}$	$I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 50\text{mA}$	$V_{\text{BE}} = 0\text{mA}$	60	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 30\text{V}$	$I_{\text{E}} = 0\text{mA}$	—	—	3.0	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$	$I_{\text{C}} = 500\text{mA}$	10	30	120	—

## DYNAMIC

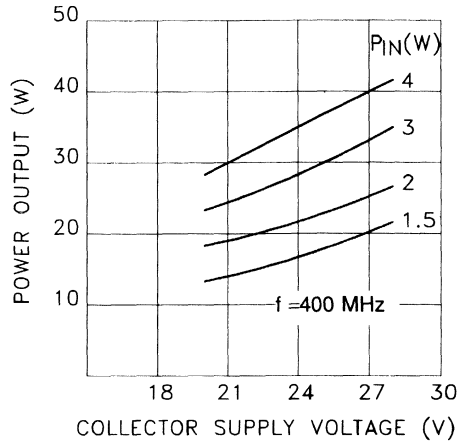
Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$P_{\text{OUT}}$	$f = 400\text{ MHz}$	$V_{\text{CC}} = 28\text{V}$	25	—	—	W
$P_{\text{IN}}$	$f = 400\text{ MHz}$	$V_{\text{CC}} = 28\text{V}$	—	—	3.15	W
$\eta_{\text{C}}$	$f = 400\text{ MHz}$	$V_{\text{CC}} = 28\text{V}$	50	55	—	%
$G_{\text{P}}$	$f = 400\text{ MHz}$	$V_{\text{CC}} = 28\text{V}$	9.0	10.5	—	dB
VSWR	$f = 400\text{ MHz}$	$V_{\text{CC}} = 28\text{V}$	20:1	—	—	—
$C_{\text{OB}}$	$f = 1\text{ MHz}$	$V_{\text{CB}} = 28\text{V}$	—	—	30	pF

## TYPICAL PERFORMANCE

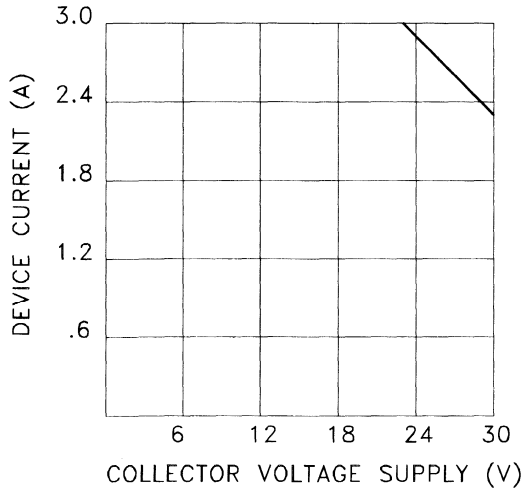
POWER INPUT vs POWER OUTPUT



POWER OUTPUT vs COLLECTOR SUPPLY VOLTAGE

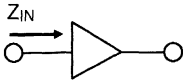


DC SAFE OPERATING AREA

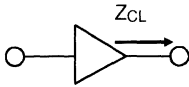


IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCE



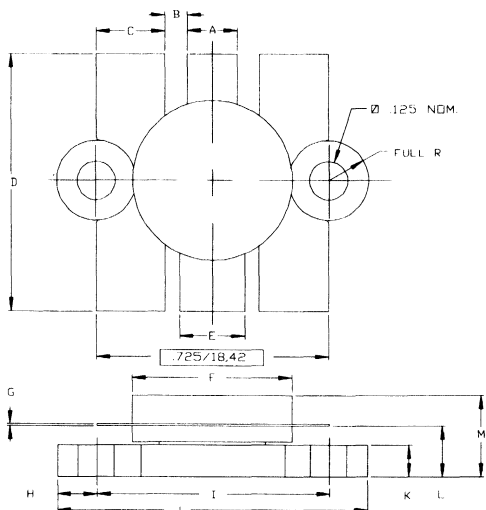
TYPICAL COLLECTOR  
LOAD IMPEDANCE



FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
225 MHz	1.40 + j 2.5	7.55 + j 0.0
275 MHz	1.25 + j 3.3	7.5 - j 0.05
300 MHz	1.10 + j 4.0	7.5 - j 1.00
350 MHz	1.10 + j 4.7	6.8 - j 1.15
400 MHz	1.70 + j 5.1	6.0 - j 1.30

## PACKAGE MECHANICAL DATA

Ref.: Dwg. No. 12-0111

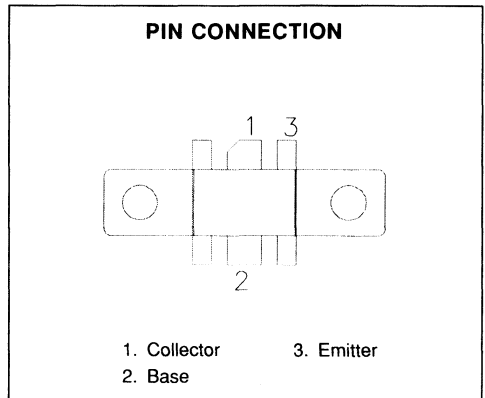
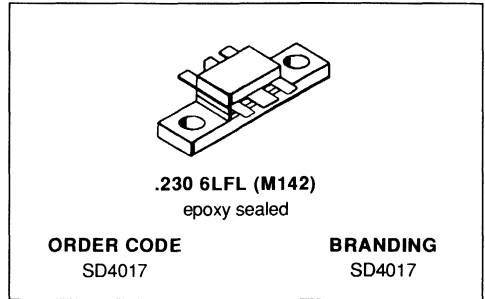


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.150/3,43	.160/4,06	K	.095/2,41	.105/2,67
B	.045/1,14		L	.150/3,81	.170/4,32
C	.210/5,33	.220/5,59	M		.280/7,11
D	.835/21,21	.865/21,97			
E	.200/5,08	.210/5,33			
F	.490/12,45	.510/12,95			
G	.003/0,08	.007/0,18			
H	.125/3,18				
I	.720/18,29	.730/18,54			
J	.970/24,64	.980/24,89			



**RF & MICROWAVE TRANSISTORS**  
**806-960 MHz CELLULAR BASE STATIONS**

- GOLD METALLIZATION
- DIFFUSED EMITTER BALLASTING
- INTERNAL INPUT MATCHING
- DESIGNED FOR LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = 30$  W MIN. WITH 7.5 dB GAIN
- $\eta_C = 55\%$  TYPICAL
- TYPICAL LOAD MISMATCH CAPABILITY:  
20:1 ALL ANGLES RATED CONDITIONS 10:1 ALL  
ANGLES @  $\pm 20\%$  RATED VOLTAGE
- TYPICAL OVERDRIVE SURVIVABILITY  
5 dB


**DESCRIPTION**

The SD4017 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity class AB operation for cellular base station applications.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^\circ C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	48	V
$V_{CEO}$	Collector-Emitter Voltage	25	V
$V_{EBO}$	Collector-Supply Voltage	3.5	V
$P_{DISS}$	Power Dissipation	88	W
$I_C$	Device Current	7.5	A
$T_J$	Junction Temperature	200	$^\circ C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^\circ C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	2.0	$^\circ C/W$
---------------	----------------------------------	-----	--------------

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 100mA$	48	55	—	V
$BV_{EBO}$	$I_E = 10mA$	3.5	5	—	V
$BV_{CEO}$	$I_C = 40mA$	25	28	—	V
$BV_{CER}$	$I_C = 40mA$ $R_{BE} = 150\Omega$	30	40	—	V
$I_{CBO}$	$V_{CE} = 24V$	10	—	—	mA
$h_{FE}$	$V_{CE} = 20V$ $I_C = 2A$	15	40	100	—

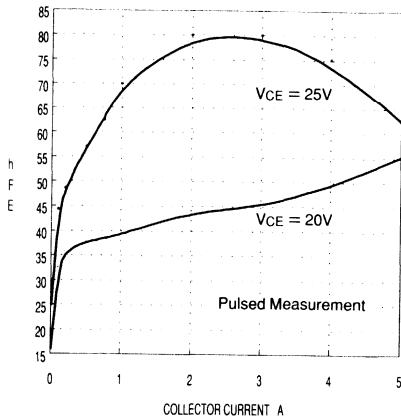
## DYNAMIC

Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$P_{OUT}$	$f = 860 MHz$ $V_{CE} = 25V$ $I_{CQ} = 60mA$	30	—	—	W
$\eta_c$	$f = 860 MHz$ $V_{CE} = 25V$ $I_{CQ} = 60mA$	—	55	—	%
$G_P$	$f = 860 MHz$ $V_{CE} = 25V$ $I_{CQ} = 60mA$	7.5	9	—	dB
$C_{OB}$	$V_{CB} = 25V$ $f_o = 1MHz$	—	42	—	pf
$IMD_3$	$P_{OUT} = 30 WPEP$ $f_1 = 860.0MHz$ $f_2 = 860.1MHz$	—	-35	—	dBc
$VSWR_1$	$VSWR = 20:1$ $V_{CE} = 25V$ $VSWR = 10:1$ $V_{CE} = 25V \pm 20\%$	No Degradation in Output Device			Typ.
$VSWR_2$	$VSWR = 5:1$ $V_{CE} = 25V \pm 20\%$ $P_{IN} = P_{IN} (norm) + 3dB$	No Degradation in Output Device			Typ.
OVD	$P_{IN}(norm) = +5dB$ $V_{CE} = 25V$ $P_{IN}(norm) = +3dB$ $V_{CE} = 25V \pm 20\%$	No Degradation in Output Device			Typ.

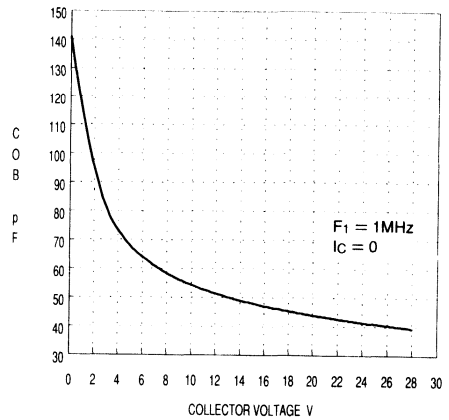


## TYPICAL PERFORMANCE

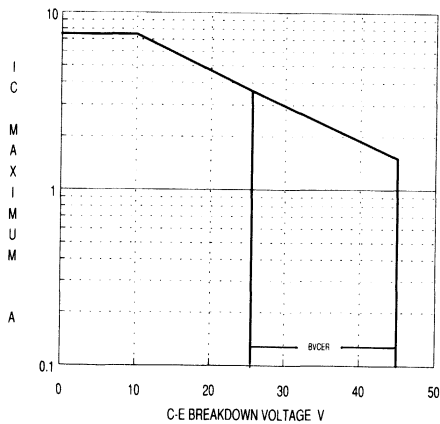
DC CURRENT GAIN vs COLLECTOR CURRENT



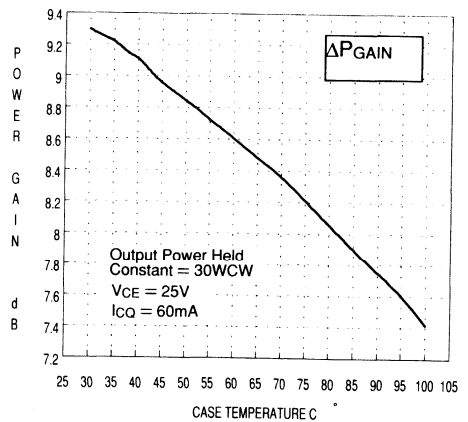
OUTPUT CAPACITANCE vs C-B VOLTAGE



DC SAFE OPERATING AREA

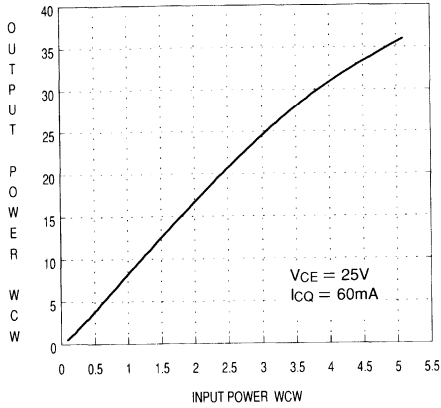


POWER GAIN vs CASE TEMPERATURE

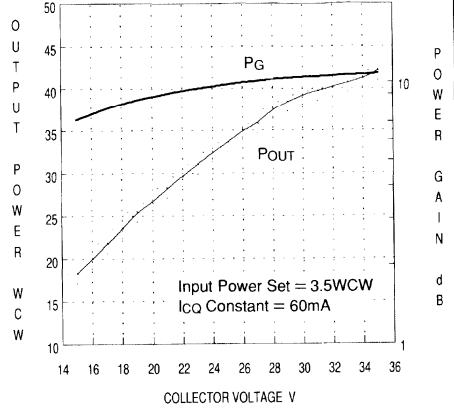


TYPICAL PERFORMANCE (cont'd)

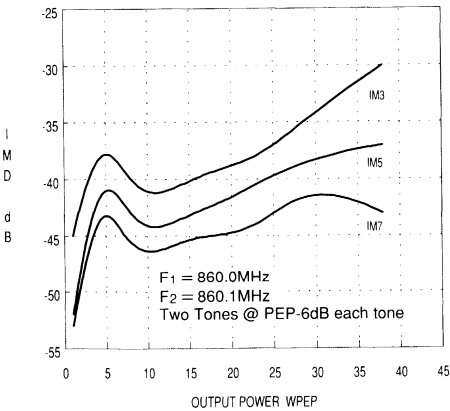
OUTPUT POWER vs INPUT POWER



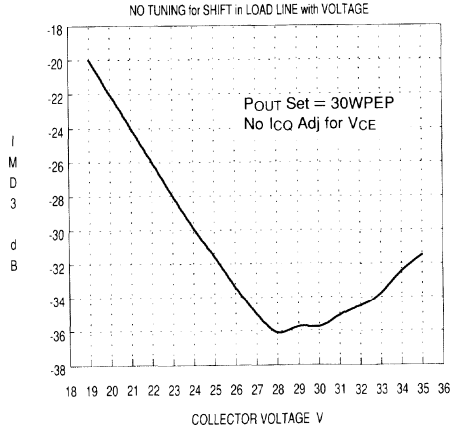
OUTPUT POWER & GAIN vs VOLTAGE



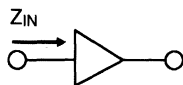
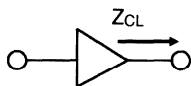
IM DISTORTION vs OUTPUT POWER



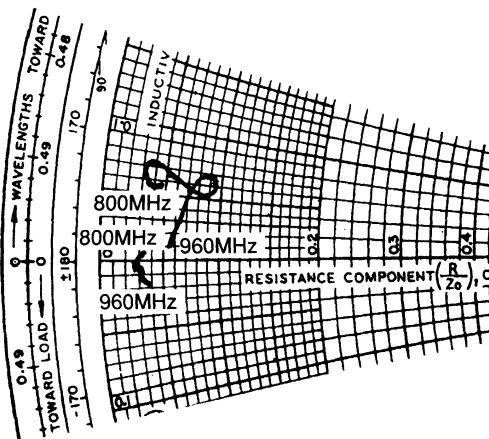
IM3 DISTORTION vs SUPPLY VOLTAGE



## IMPEDANCE DATA

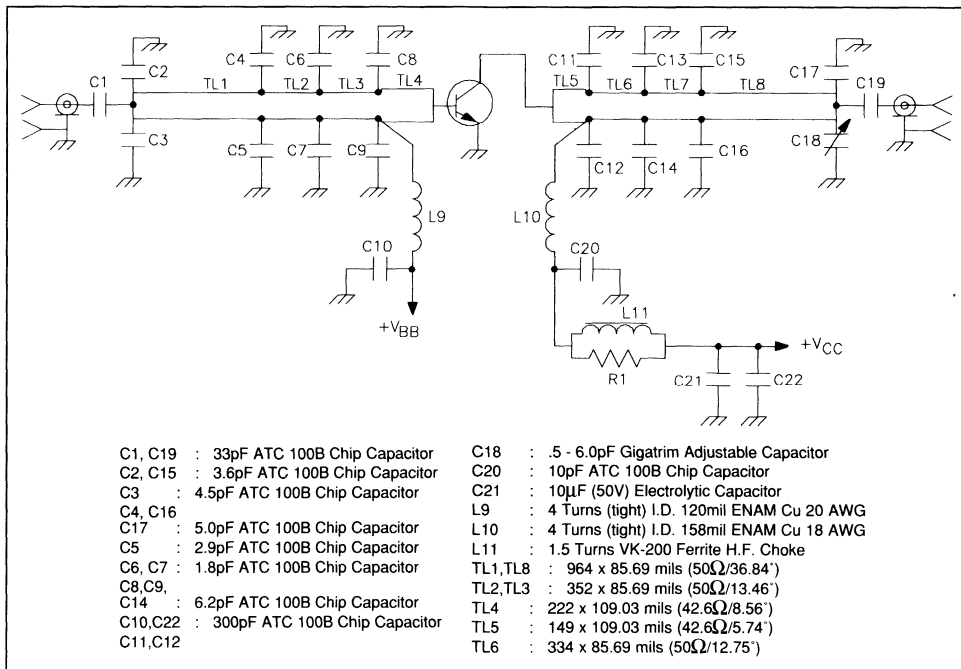
TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
800 MHz	4.3 + j 5.8	3.5 + j 0.2
830 MHz	3.2 + j 6.1	3.5 + j 0.1
860 MHz	3.5 + j 7.1	2.9 - j 0.2
900 MHz	5.3 + j 6.4	3.0 - j 0.6
915 MHz	6.1 + j 6.3	3.2 - j 0.7
930 MHz	9.4 + j 6.3	3.2 - j 1.1
945 MHz	6.6 + j 3.0	3.3 - j 1.2
960 MHz	5.9 + j 1.0	3.4 - j 1.5

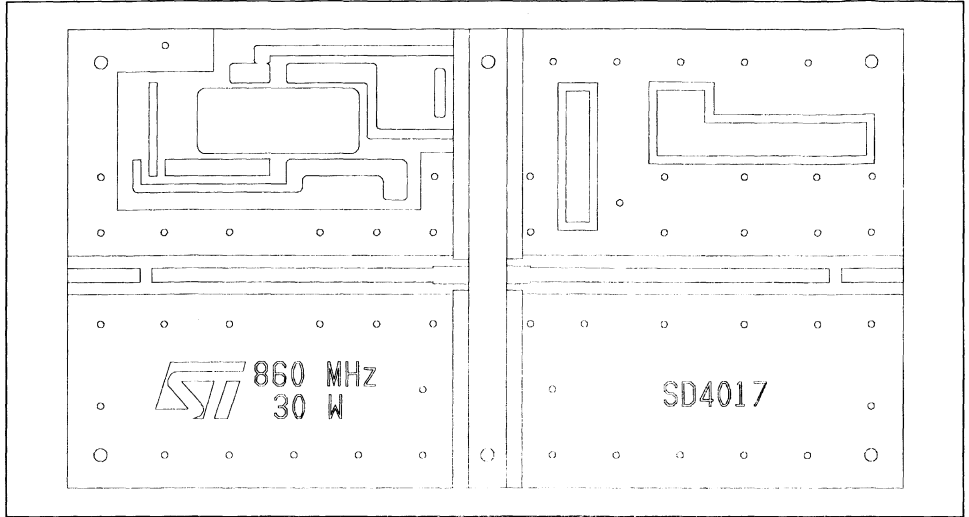


P<sub>OUT</sub> = 30W  
V<sub>CE</sub> = 25 V  
Normalized to 50 ohms

## TEST CIRCUIT

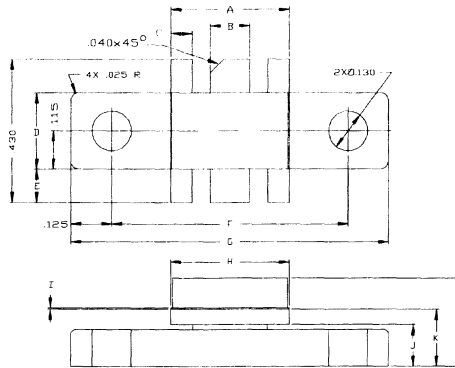


BOARD LAYOUT



PACKAGE MECHANICAL DATA

Ref. Dwg.No. 12-0142

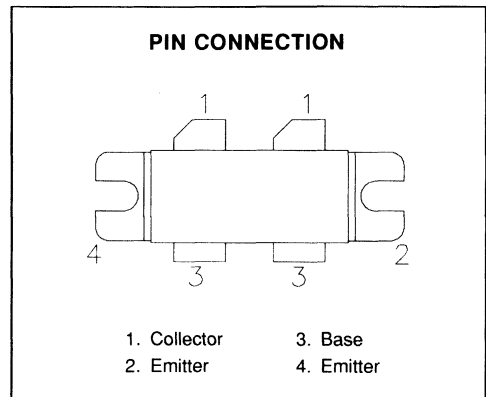
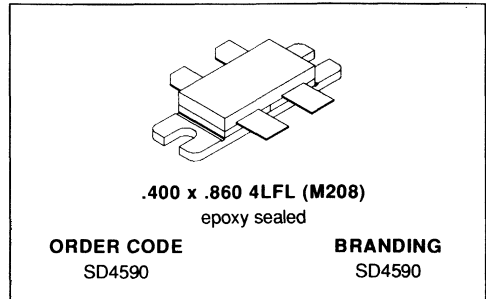


SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.355/9.02	.365/9.27	K	.160/4.06
B	.115/2.92	.125/3.18	L	.230/5.84
C	.075/1.91	.085/2.16		
D	.225/5.72	.235/5.97		
E	.090/2.29	.110/2.79		
F	.720/18.29	.730/18.54		
G	.970/24.64	.980/24.89		
H	.355/9.02	.365/9.27		
I	.004/0.10	.006/0.15		
J	.120/3.05	.130/3.30		

**RF & MICROWAVE TRANSISTORS**  
**800-960MHz CELLULAR BASE STATION**

PRELIMINARY DATA

- GOLD METALLIZATION
- INTERNAL INPUT/OUTPUT MATCHING
- DIFFUSED EMITTER BALLASTING
- COMMON EMITTER CONFIGURATION
- DESIGNED FOR LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- $P_{OUT} = 150$  W PEP
- MIN. GAIN 8.0 dB @ 900 MHz
- MAX. INTERMODULATION DISTORTION -28dBc @ 150 W PEP
- 5:1 VSWR CAPABILITY @ RATED CONDITIONS
- 3 dB OVERDRIVE CAPABILITY


**DESCRIPTION**

The SD4590 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in 900 MHz cellular base station applications.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CEO}$	Collector-Emitter Voltage	28	V
$V_{CES}$	Collector-Emitter Voltage	60	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_c$	Device Current	25	A
$P_{DISS}$	Power Dissipation	300	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.60	$^{\circ}\text{C/W}$
---------------	----------------------------------	------	----------------------

ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

## STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CEO}$	$I_C = 100mA$	$I_B = 0mA$	26	30	—	V
$BV_{CER}$	$I_C = 100mA$	$R_{BE} = 200\Omega$	35	40	—	V
$BV_{CES}$	$I_C = 50mA$	$V_{BE} = 0V$	60	80	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	4.0	—	V
$I_{CES}$	$V_{CE} = 30V$	$V_{BE} = 0V$	—	—	10	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	30	45	120	—

Tested per side

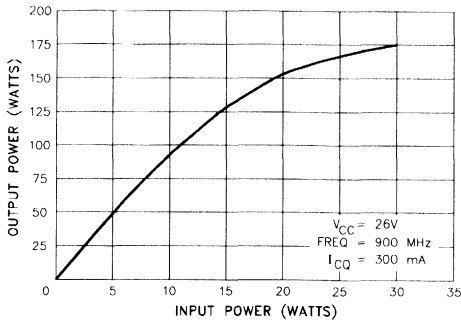
## DYNAMIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$C_{OB}$	$f = 1.0 \text{ MHz}$	$V_{CB} = 26 \text{ Vdc}$ for information only - this part is collector matched	—	75	—	pF
$G_P^*$	$V_{CC} = 26 \text{ Vdc}$	$P_{OUT} = 150W \text{ PEP}$ $I_{CQ} = 2 \times 150mA$	8.0	9.0	—	dB
$\eta_c^*$	$V_{CC} = 26 \text{ Vdc}$	$P_{OUT} = 150W \text{ PEP}$ $I_{CQ} = 2 \times 150mA$	35	45	—	%
$IMD^*$	$V_{CC} = 26 \text{ Vdc}$	$P_{OUT} = 150W \text{ PEP}$ $I_{CQ} = 2 \times 150mA$	—	-32	-28	dBc
Load* Mismatch	$V_{CC} = 26 \text{ Vdc}$	$P_{OUT} = 150W \text{ PEP}$ $I_{CQ} = 2 \times 150mA$ $VSWR = 5:1$ @ all phase angles	No Degradation in Output Power			

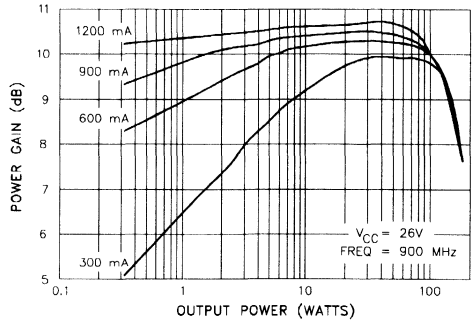
\*Note:  $f_1 = 900.0 \text{ MHz}$  $f_2 = 900.1 \text{ MHz}$

## TYPICAL PERFORMANCE

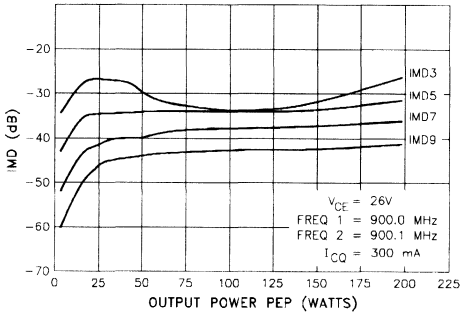
POWER OUTPUT vs POWER INPUT



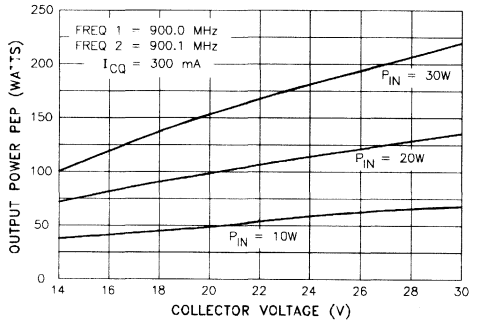
POWER GAIN vs POWER OUTPUT



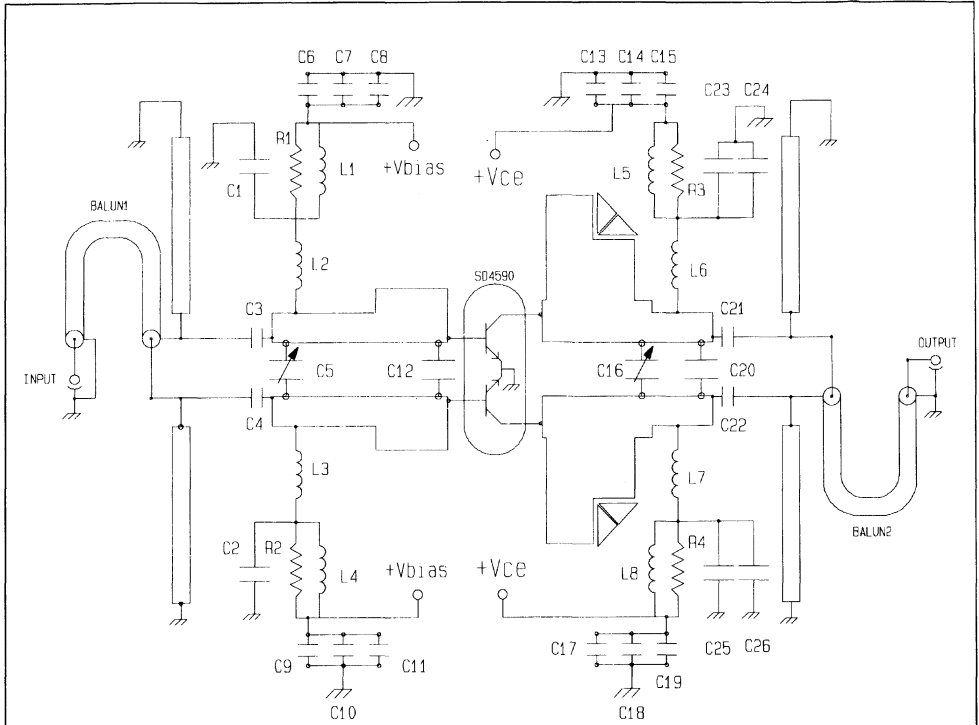
INTERMODULATION DISTORTION vs POWER OUTPUT



POWER OUTPUT vs SUPPLY VOLTAGE



TEST CIRCUIT



Balun 1, 2 : 50Ω Coaxial Cable Length 2.2"

- C1, C2, C23, C25 : 91pF Ceramic Chip, ATC B
- C3, C4, C21, C22 : 2 x 39pF Ceramic Chip, ATC B
- C5, C16 : 0.8 - 8pF Variable, JOHANSON Giga-Trim
- C6, C9, C15, C19 : 1000pF Ceramic Chip, ATC B
- C7, C10, C14, C18 : 20nF Ceramic Chip, ATC B
- C8, C11 : 100μF, 50V Electrolytic
- C13, C17 : 470μF, 50V Electrolytic
- C12 : 9.1pF, Ceramic Chip, ATC A

- C20 : 1.3pF Ceramic Chip, ATC B
- C24, C26 : 47μF, 35V Tantalum

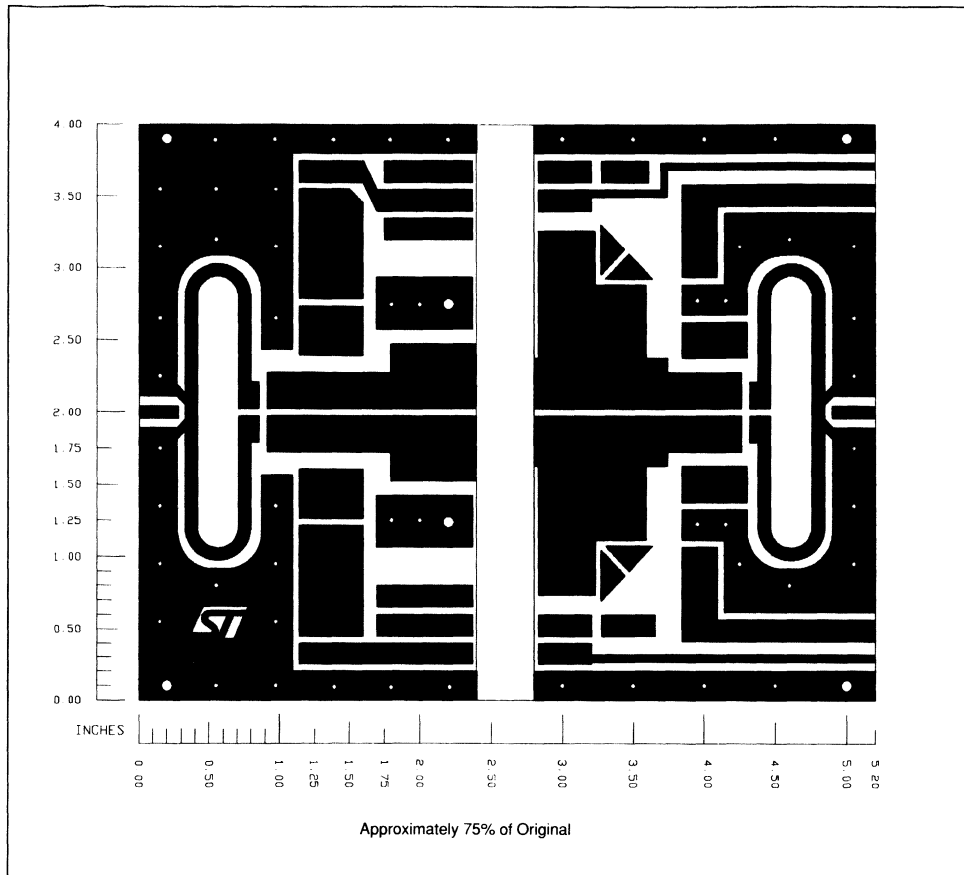
- L1, L4, L5, L8 : 12 Turns, #22 AWG, 0.15" I.D. (Tight)
- L2, L3, L6, L7 : 4 Turns, #20 AWG, 0.13" I.D. (1:1)

- R1, R2, R3, R4 : 5 x 50Ω Chip Resistor

Board Material : ROGERS, Er = 2.55, Height = 31.25 mil  
1 oz. Cu.  
See Photomaster for Microstrip Lines.

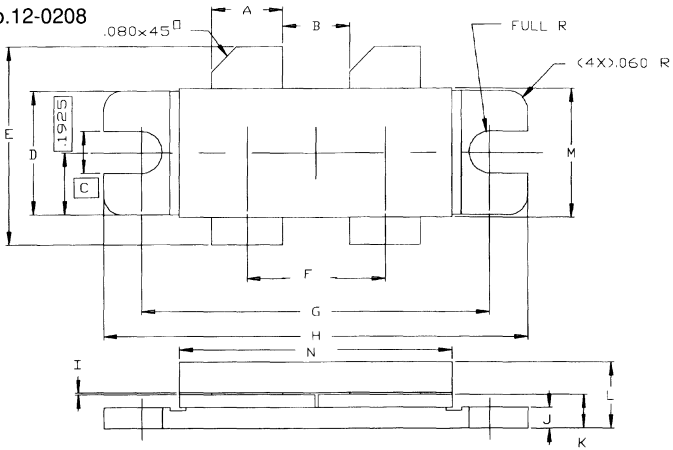


## PHOTOMASTER OF TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0208

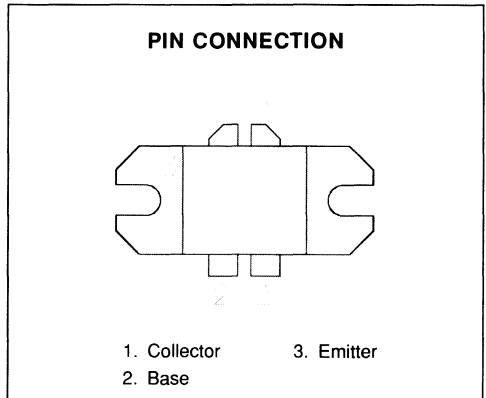
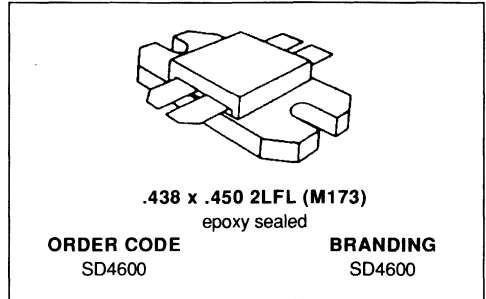


SGS-THOMSON MICROELECTRONICS			CONT'D	
	MINIMUM Inches/mm	MAXIMUM Inches/mm	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.220/5,59	.230/5,84	K	.082/2,08 .097/2,46
B	.210/5,33		L	.205/5,21
C	.125/3,18		M	.395/10,03 .407/10,34
D	.380/9,65	.390/9,91	N	.850/21,59 .870/22,10
E	.580/14,73	.620/15,75		
F	.435/11,05			
G	1.090/27,69	1.105/28,07		
H	1.335/33,91	1.345/34,16		
I	.003/0,08	.007/0,18		
J	.060/1,52	.070/1,78		

## RF & MICROWAVE TRANSISTORS CELLULAR BASE STATION APPLICATIONS

PRELIMINARY DATA

- GOLD METALLIZATION
- 860-960 MHz
- 26 VOLTS
- EFFICIENCY 50% MIN.
- P<sub>OUT</sub> = 60 W MIN. WITH 7.5 dB GAIN



### DESCRIPTION

The SD4600 is designed for 960MHz mobile base stations in both analog and digital applications. Including double input and output matching networks, the SD4600 features high impedances allowing operation over the full 860 to 960 MHz bandwidth.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	60	V
V <sub>CEO</sub>	Collector-Emitter Voltage	28	V
V <sub>EBO</sub>	Emitter-Base Voltage	3.5	V
I <sub>C</sub>	Device Current	8	A
P <sub>DISS</sub>	Power Dissipation	146	W
T <sub>J</sub>	Junction Temperature	+200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +150	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance	1.2	°C/W
----------------------	----------------------------------	-----	------

\*Applies only to rated RF amplifier operation

# SD4600

## ELECTRICAL SPECIFICATIONS (T<sub>case</sub> = 25°C)

### STATIC (Total Device)

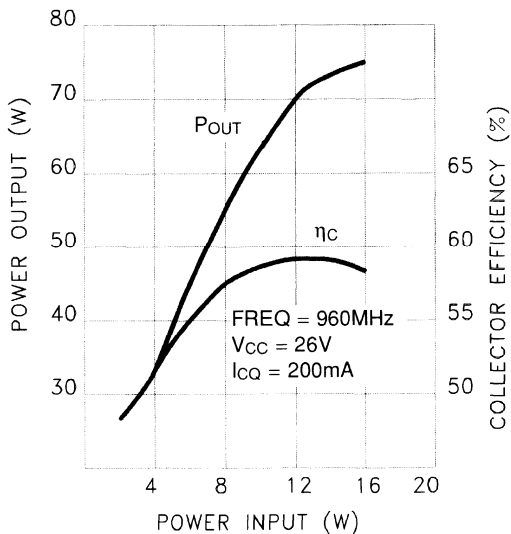
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
BV <sub>CBO</sub>	I <sub>C</sub> = 100mA	60	—	—	V
BV <sub>EBO</sub>	I <sub>E</sub> = 20mA	3.5	—	—	V
BV <sub>CEO</sub>	I <sub>C</sub> = 100mA	28	—	—	V
I <sub>CEO</sub>	V <sub>CE</sub> = 25V	—	—	30	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V      I <sub>C</sub> = 3A	25	—	80	—

### DYNAMIC (Total Device)

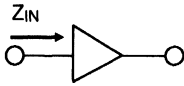
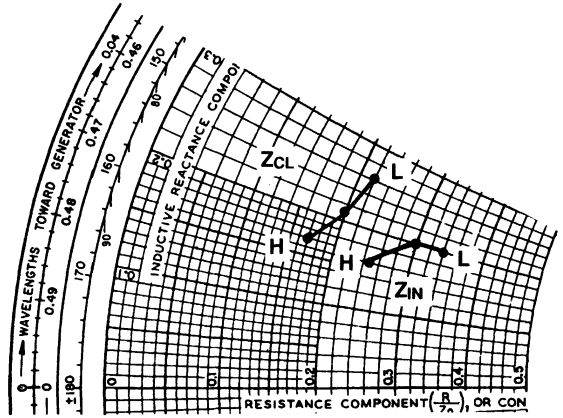
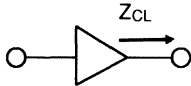
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
P <sub>OUT</sub>	f = 960MHz      V <sub>CC</sub> = 26V      I <sub>CQ</sub> = .200A	60	65	—	W
η <sub>C</sub>	f = 960MHz      V <sub>CC</sub> = 26V      I <sub>CQ</sub> = .200A	50	58	—	%
G <sub>P</sub>	f = 960MHz      V <sub>CC</sub> = 26V      I <sub>CQ</sub> = .200A	7.5	8.0	—	dB
VSWR	f = 960MHz      V <sub>CC</sub> = 26V	5:1	—	—	—

## TYPICAL PERFORMANCE

### POWER OUTPUT & COLLECTOR EFFICIENCY vs POWER INPUT



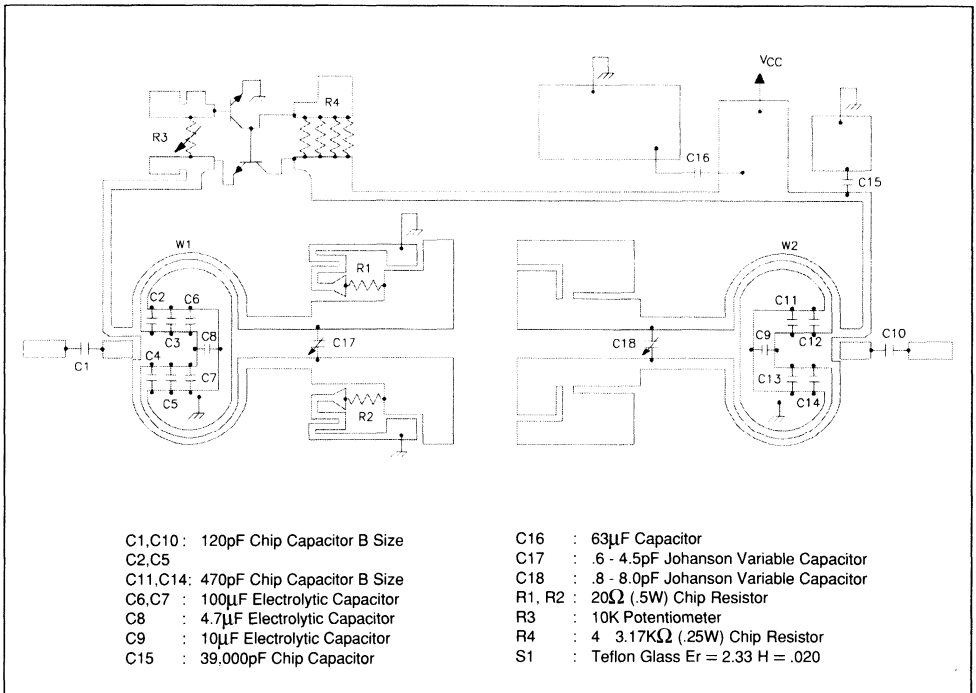
## IMPEDANCE DATA

TYPICAL INPUT  
IMPEDANCETYPICAL COLLECTOR  
LOAD IMPEDANCE

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
860 MHz	17 + j 10	11 + j 12
900 MHz	14 + j 10	10 + j 10.5
960 MHz	12.5 + j 8	8.5 + j 8.5

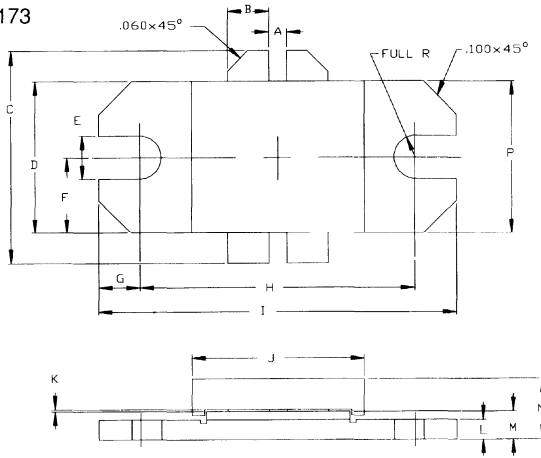
P<sub>OUT</sub> = 60W  
V<sub>CC</sub> = 26V  
Normalized to 50ohms

## TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref. Dwg. No.: 12-0173

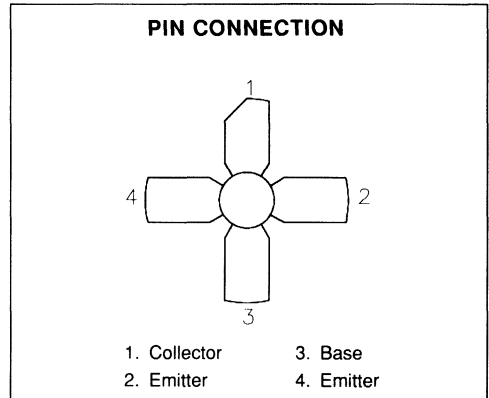
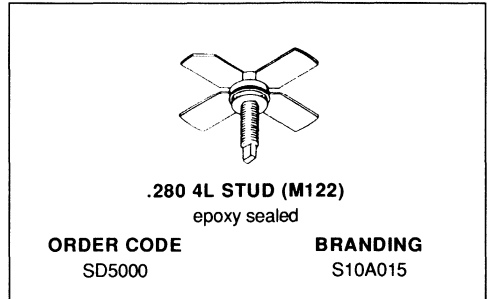


SGS-THOMSON MICROELECTRONICS			CONT'D		
	MINIMUM Inches/mm	MAXIMUM Inches/mm		MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.055/1,40		K	.002/0,05	.006/0,15
B	.120/3,05	.130/3,30	L	.055/1,40	.065/1,65
C	.785/19,94		M	.080/2,03	.095/2,41
D	.455/11,56	.465/11,81	N	.195/4,95	
E	.125/3,18		P	.455/11,56	.465/11,81
F	.230/5,84				
G	.128/3,25				
H	.838/21,28	.850/21,59			
I	1.095/27,81	1.105/28,07			
J	.525/13,34	.535/13,59			

## RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

PRELIMINARY DATA

- GOLD METALLIZATION
- EMITTER SITE BALLASTING
- INTERNAL INPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC PACKAGE
- COMMON EMITTER CONFIGURATION
- $P_{OUT} = 1.5 \text{ W MIN. WITH } 9.5 \text{ dB GAIN}$



### DESCRIPTION

The SD5000 is a NPN Silicon Transistor designed for high gain linear performance at 1000 MHz.

This part uses gold metallized die and polysilicon site ballasting to achieve high reliability and ruggedness.

The SD5000 can be used for applications such as Telecommunications, Radar, ECM, Space and other commercial and military systems.

### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}\text{C}$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	50	V
$V_{CES}$	Collector-Emitter Voltage	50	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	1.0	A
$P_{DISS}$	Power Dissipation	7.0	W
$T_J$	Junction Temperature	+200	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}\text{C}$

### THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	25	$^{\circ}\text{C/W}$
---------------	----------------------------------	----	----------------------

**SD5000****ELECTRICAL SPECIFICATIONS** ( $T_{\text{case}} = 25^{\circ}\text{C}$ )**STATIC**

Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$BV_{\text{CBO}}$	$I_{\text{C}} = 10\text{mA}$	50	—	—	V
$BV_{\text{EBO}}$	$I_{\text{E}} = 5\text{mA}$	3.5	—	—	V
$BV_{\text{CES}}$	$I_{\text{C}} = 10\text{mA}$	50	—	—	V
$BV_{\text{CEO}}$	$I_{\text{C}} = 5\text{mA}$	23	—	—	V
$I_{\text{CBO}}$	$V_{\text{CB}} = 28\text{V}$	—	0.2	—	mA
$h_{\text{FE}}$	$V_{\text{CE}} = 5\text{V}$ $I_{\text{C}} = 100\text{mA}$	18	—	200	—

**DYNAMIC**

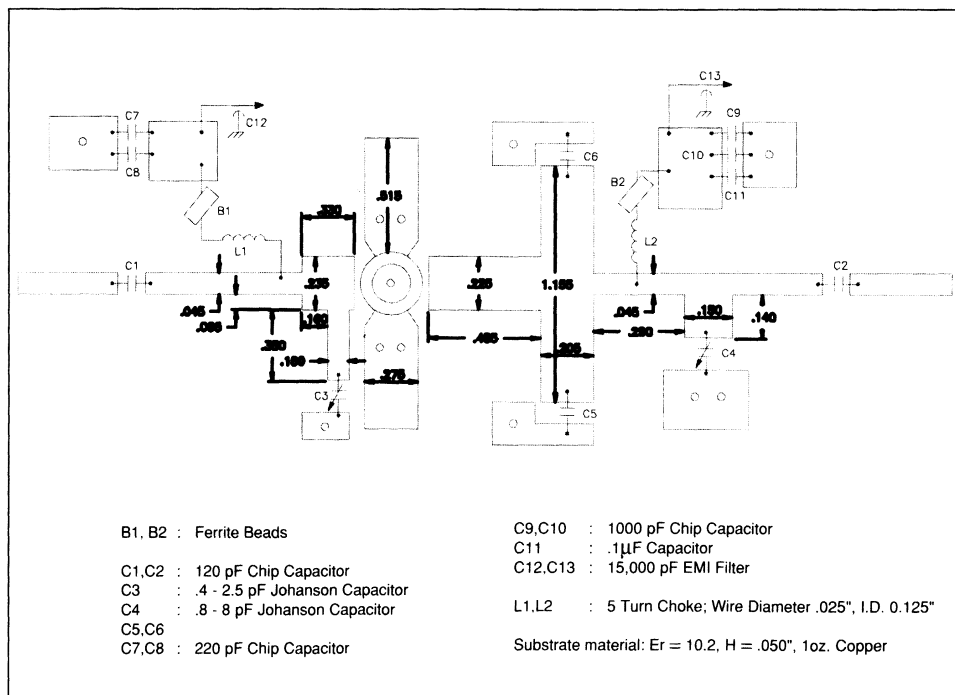
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
$P_{\text{OUT}} 1\text{dB}$	$f = 1\text{GHz}$ $V_{\text{CC}} = 20\text{V}$ $I_{\text{C}} = 220\text{mA}$	1.5	—	—	W
$G_{\text{P}}$	$f = 1\text{GHz}$ $V_{\text{CC}} = 20\text{V}$ $I_{\text{C}} = 220\text{mA}$	9.5	—	—	dB
VSWR	$f = 1\text{GHz}$ $V_{\text{CC}} = 20\text{V}$ $I_{\text{C}} = 220\text{mA}$	—	—	25:1	—
$C_{\text{OB}}$	$f = 1\text{MHz}$ $V_{\text{CB}} = 20\text{V}$	—	—	4.0	pF



## IMPEDANCE DATA

FREQ.	Z <sub>IN</sub> (Ω)	Z <sub>CL</sub> (Ω)
1000 MHz	4.0 + j 3.3	20.8 + j 33.3

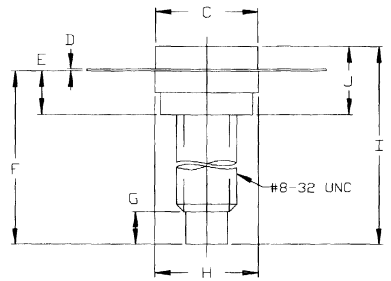
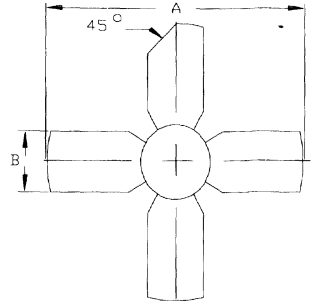
## TEST CIRCUIT



PACKAGE MECHANICAL DATA

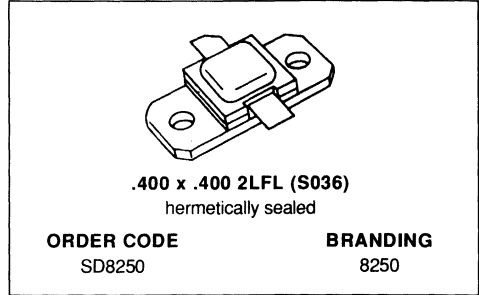
Ref.: Dwg. No. 12-0122

SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	1.010/25,65	1.055/26,80
B	.220/5,59	.230/5,84
C	.270/6,86	.285/7,24
D	.003/0,08	.007/0,18
E	.117/2,97	.137/3,48
F	.572/14,53	
G	.130/3,30	
H	.275/6,99	.285/7,24
I	.640/16,26	
J	.175/4,45	.217/5,51



## RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY @ 1.75 dB RF OVERDRIVE
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 250 W MIN. WITH 8.0 dB GAIN



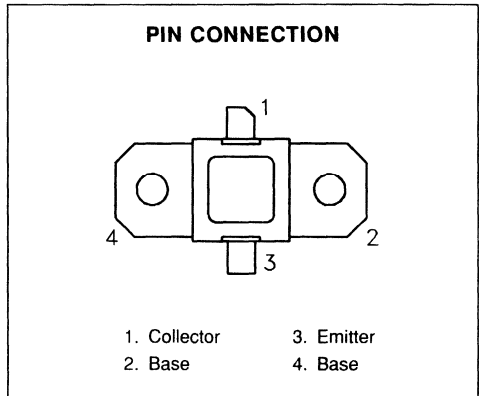
### DESCRIPTION

The SD8250 is a high power Class C transistor specifically designed for TACAN/DME pulsed output and driver applications.

This device is designed for operation under moderate pulse width and duty cycle pulse conditions and is capable of withstanding 5:1 output VSWR at rated RF overdrive.

Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The SD8250 is supplied in the AMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>c</sub> ≤ 90°C)	575	W
I <sub>c</sub>	Device Current*	20	A
V <sub>CC</sub>	Collector-Supply Voltage*	50	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance <sup>(1)</sup>	0.28	°C/W
----------------------	---	------	------

\*Applies only to rated RF amplifier operation

(1) Infra-Red Scan of Hot Spot Junction Temperature at Rated RF Operating Conditions

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

**STATIC**

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 35mA$	$I_E = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 15mA$	$I_C = 0mA$	4.0	—	—	V
$BV_{CES}$	$I_C = 25mA$	$I_B = 0mA$	60	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 50V$	—	—	20	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 1A$	10	—	—	—

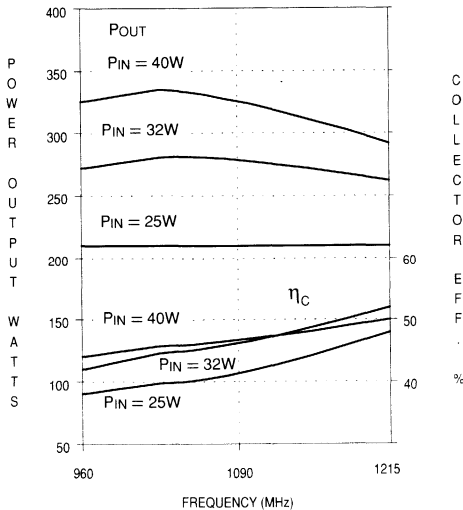
**DYNAMIC**

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 960 - 1215$ MHz	$P_{IN} = 40$ W	$V_{CC} = 50$ V	250	295	—	W
$\eta_C$	$f = 960 - 1215$ MHz	$P_{IN} = 40$ W	$V_{CC} = 50$ V	38	44	—	%
GP	$f = 960 - 1215$ MHz	$P_{IN} = 40$ W	$V_{CC} = 50$ V	8.0	8.7	—	dB

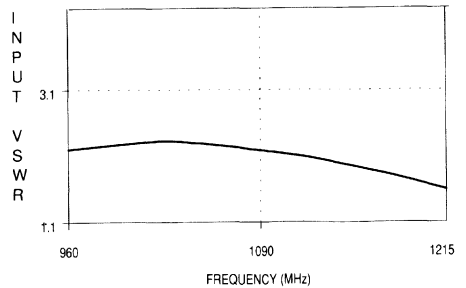
Note: Pulse Width = 20 $\mu$ Sec  
 Duty Cycle = 5%  
 $T_c$  = 25 $^{\circ}$ C

**TYPICAL PERFORMANCE**

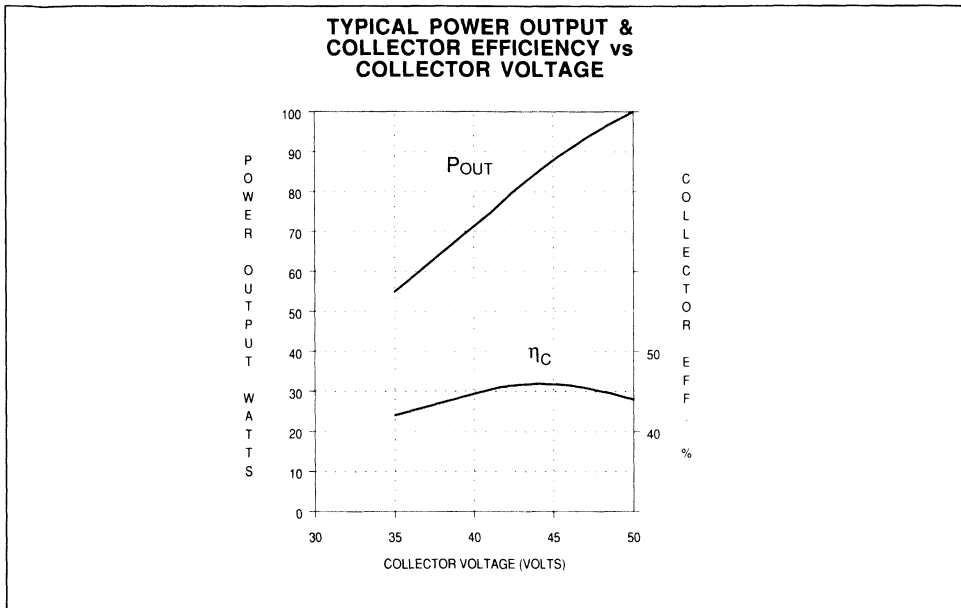
**TYPICAL BROADBAND POWER AMPLIFIER**



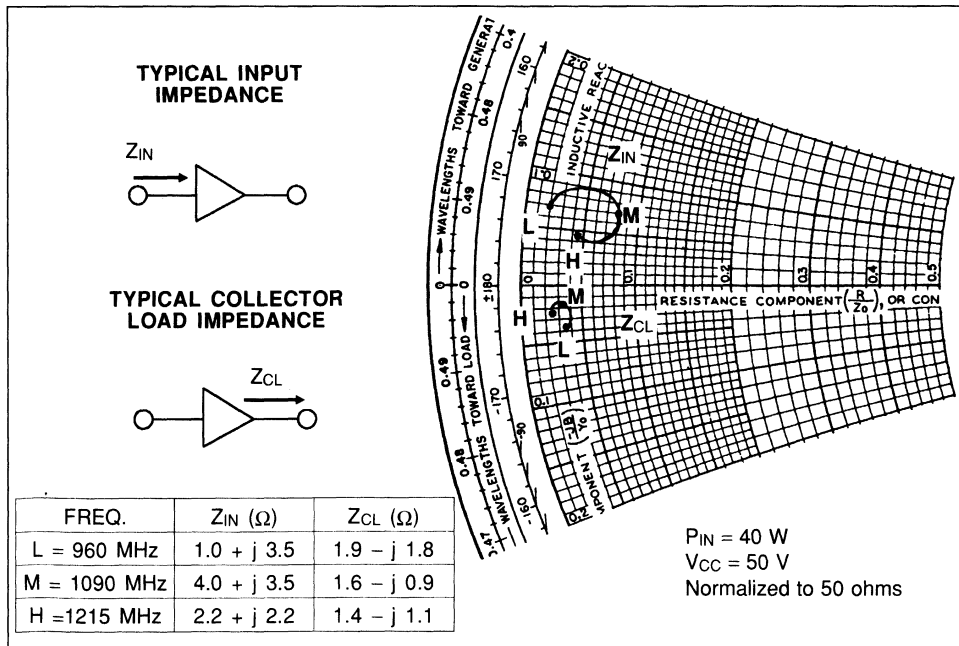
**INPUT VSWR vs FREQUENCY**



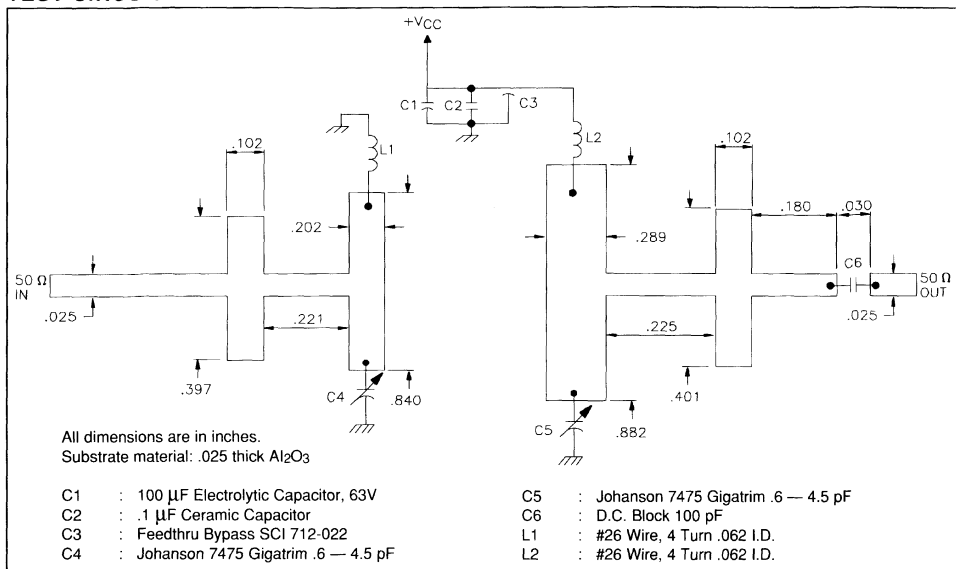
TYPICAL PERFORMANCE (cont'd)



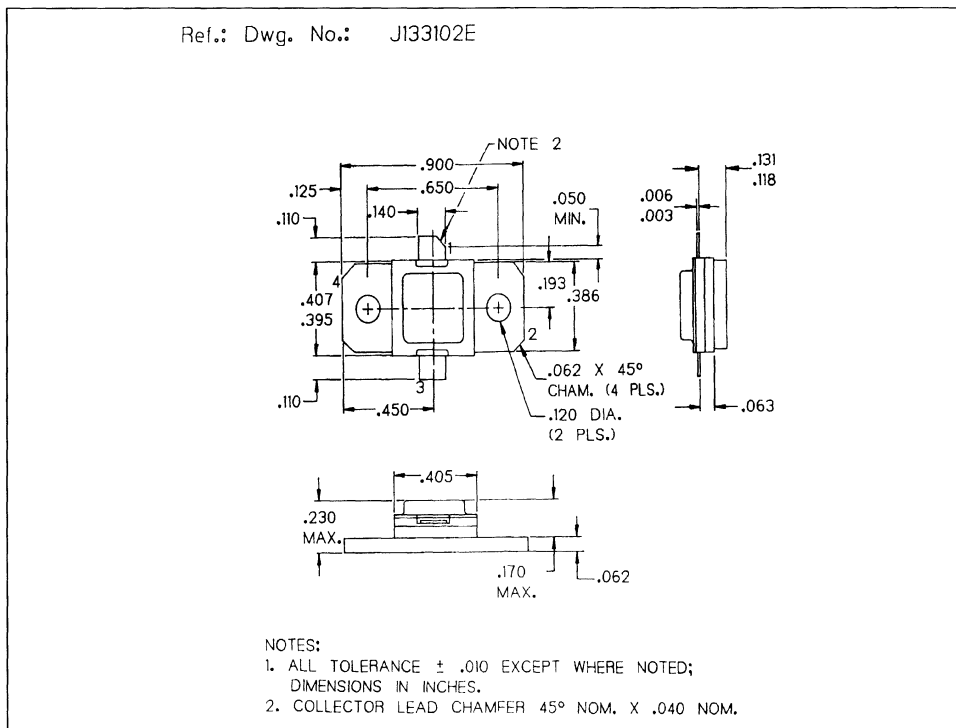
IMPEDANCE DATA



TEST CIRCUIT



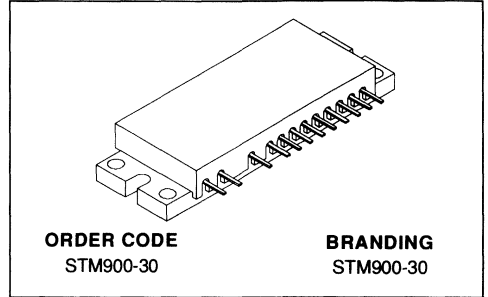
PACKAGE MECHANICAL DATA



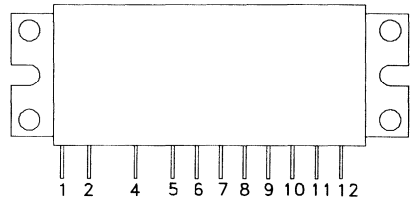
## RF POWER MODULE DIGITAL CELLULAR APPLICATIONS

PRELIMINARY DATA

- LINEAR POWER AMPLIFIER
- 860 - 900 MHz
- 26 VOLTS
- INPUT/OUTPUT 50 OHMS
- $P_{OUT} = +45$  dBm PEP
- GAIN = 36 dB MIN.



### PIN CONNECTION



- |             |             |              |               |
|-------------|-------------|--------------|---------------|
| 1. RF Input | 2. $V_{G1}$ | 3. deleted   | 4. $V_{G2}$   |
| 5. $V_D$    | 6. $V_{B1}$ | 7. $D_1$     | 8. $V_{C1}$   |
| 9. $V_{B2}$ | 10. $D_2$   | 11. $V_{C2}$ | 12. RF Output |

### DESCRIPTION

The STM900-30 module is designed for digital cellular radio base station applications in the 860-900 MHz frequency range operating at 26V.

The STM900-30 is designed to meet the low distortion, high linearity requirements of modern digital cellular base station equipment.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
$V, V_D, V_{C1}, V_{C2}$	DC Supply Voltage	28	Vdc
$I_{Q1}$	Bias Current @ $V = 26V$ , 1st Stage	0.40	Adc
$I_{Q2}$	Bias Current @ $V = 26V$ , 2nd Stage	0.40	Adc
$I_{Q3}$	Bias Current @ $V = 26V$ , 3rd Stage	0.54	Adc
$I_{Q4}$	Bias Current @ $V = 26V$ , 4th Stage	1.62	Adc
$P_{IN}$	RF Input Power ( $P_{OUT} < 45$ dBm PEP)	14	dBm PEP
$P_{OUT}$	RF Output Power ( $V = 26V$ )	48	dBm PEP
$T_{STG}$	Storage Temperature	- 30 to +100	°C

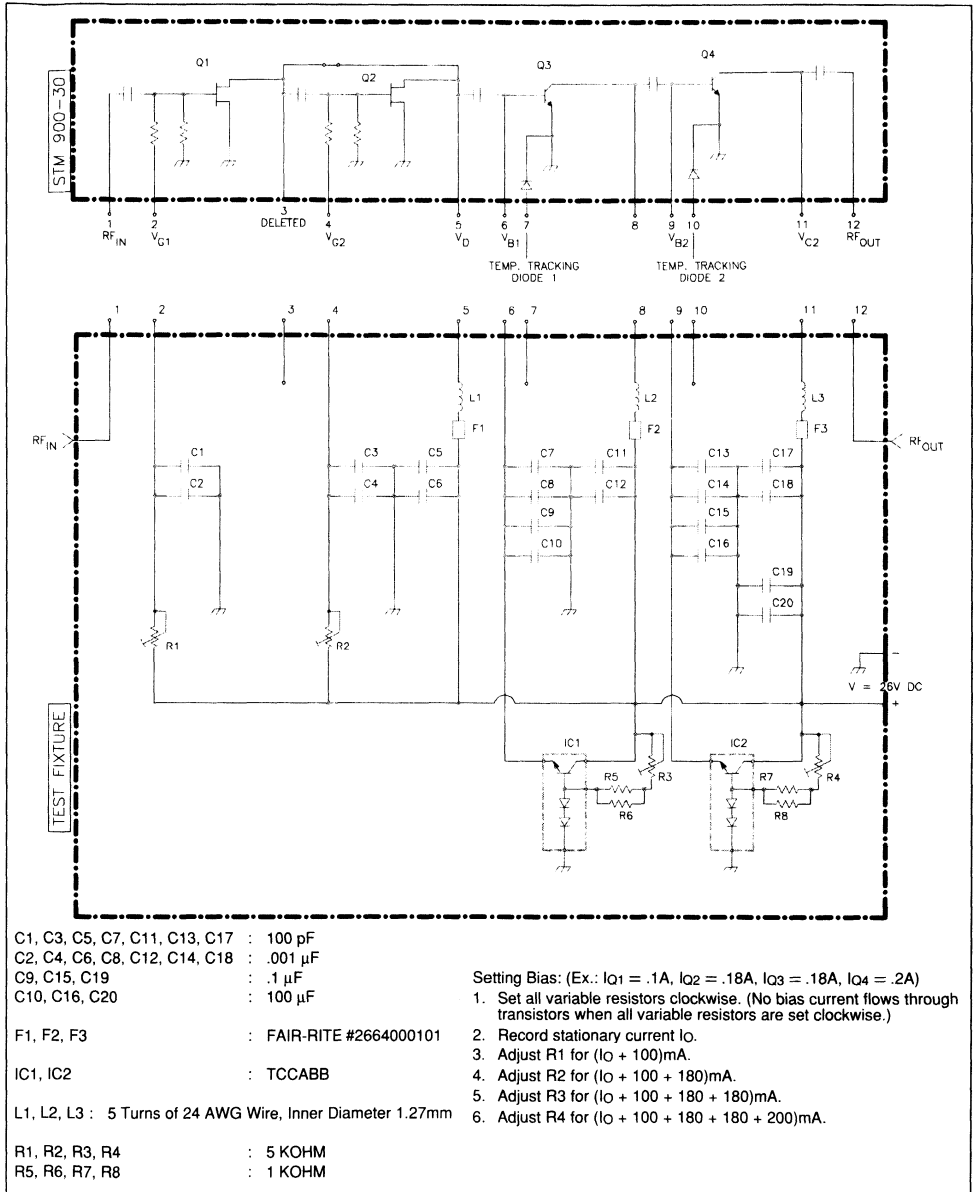
**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ ,  $V_D, V_{C1}, V_{C2} = 26V$ ) ( $I_{DQ1} = 100mA$ ,  
 $I_{DQ2} = 180mA$ ,  $I_{CQ1} = 180mA$ ,  $I_{CQ2} = 200mA$ )

Symbol	Parameter	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
BW	Frequency Range		860	—	900	MHz
G <sub>P</sub>	Power Gain	P <sub>OUT</sub> = +42 dBm CW	36	38	—	dB
$\eta_{dt}^*$	Double-Tone Efficiency	P <sub>OUT</sub> = +45 dBm PEP	25	28	—	%
Z <sub>IN</sub>	Input Impedance	P <sub>OUT</sub> = +42 dBm CW    Z <sub>S</sub> , Z <sub>L</sub> = 50 $\Omega$	—	1.5	2.0	VSWR
IMD*	Intermodulation Distortion	P <sub>OUT</sub> = +45 dBm PEP	—	-34	-30	dB <sup>T</sup> **
—	Power Degradation	P <sub>OUT</sub> = +42 dBm CW T <sub>C</sub> = 0 $^{\circ}C$ to 70 $^{\circ}C$	—	1.5	—	—
—	Load Mismatch	VSWR = 5:1    V = 26Vdc P <sub>OUT</sub> = +45 dBm PEP	No Degradation in Output Power			

Note: \* Two-Tone test; 20 KHz separation    \*\* dB<sup>T</sup> - in dB, referenced to tone level

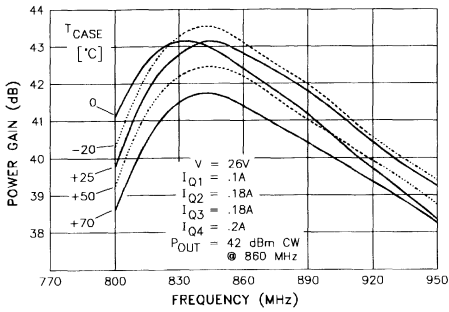


## MODULE DC AND TEST FIXTURE CONFIGURATION

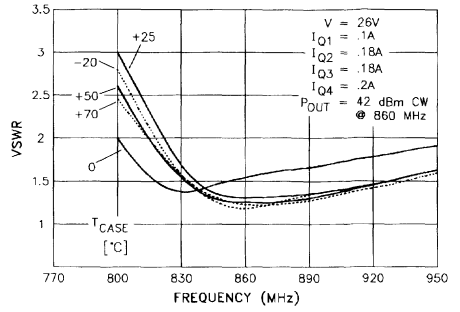


TYPICAL PERFORMANCE

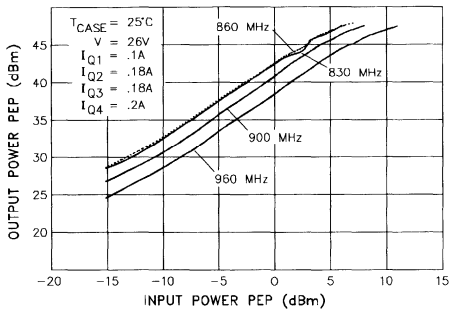
GAIN vs FREQUENCY & TEMPERATURE



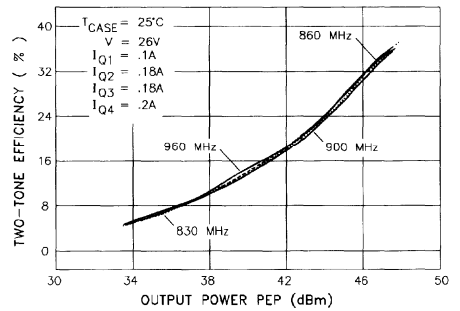
VSWR vs FREQUENCY & TEMPERATURE



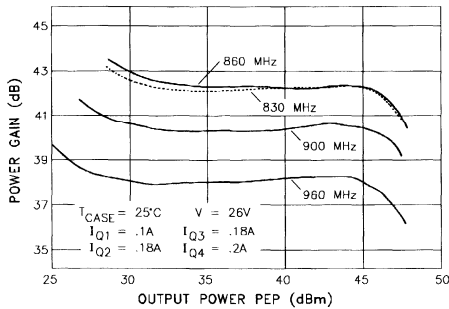
POWER OUTPUT vs POWER INPUT



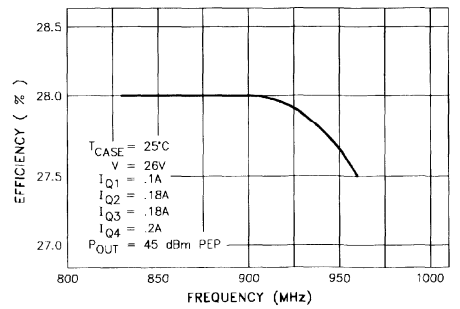
TWO-TONE EFFICIENCY vs POWER OUTPUT



POWER GAIN vs POWER OUTPUT

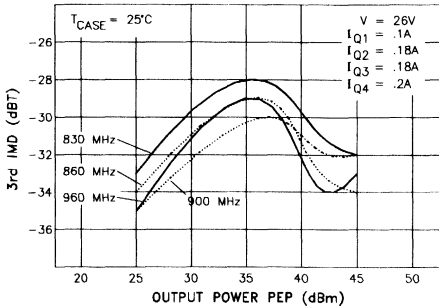


EFFICIENCY vs FREQUENCY

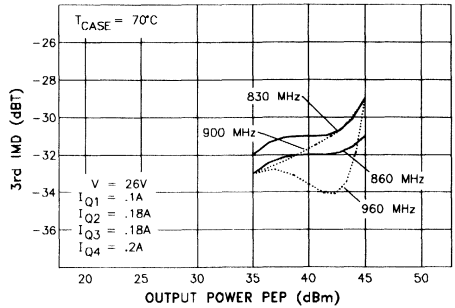


TYPICAL PERFORMANCE

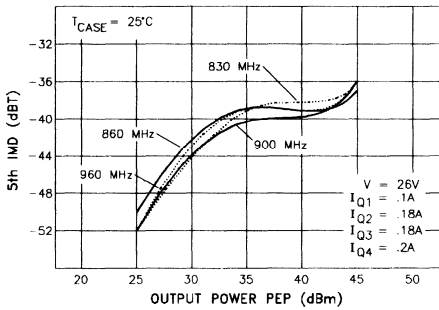
3rd IMD vs POWER OUTPUT & TEMPERATURE



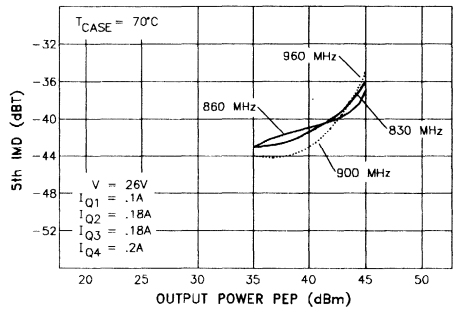
3rd IMD vs POWER OUTPUT & TEMPERATURE



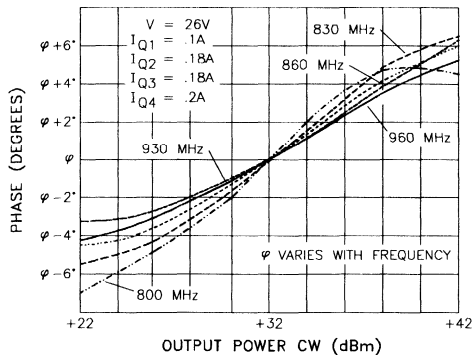
5th IMD vs POWER OUTPUT & TEMPERATURE



5th IMD vs POWER OUTPUT & TEMPERATURE



PHASE THROUGH MODULE vs POWER OUTPUT



**APPLICATIONS RECOMMENDATIONS**

**OPERATION LIMITS**

The STM900-30 power module should never be operated under any condition which exceeds the Absolute Maximum Ratings presented on this data sheet. Nor should the module be operated continuously at any of the specified maximum ratings. If the module is to be operated under any condition such that it may be subjected to one or more of the maximum rating conditions, care must be taken to monitor other parameters which may be affected.

**DECOUPLING**

Failure to properly decouple any of the voltage supply pins will result in oscillations at certain operating frequencies. Therefore, it is recommended that these pins be bypassed as indicated in the Module DC and Test Fixture Configuration drawing of this data sheet.

**MODULE MOUNTING**

To insure adequate thermal transfer from the module to the heatsink, it is recommended that a satisfactory thermal compound such as Dow Corning 340, Wakefield 120-2 or equivalent be applied between the module flange and the heatsink.

The heatsink mounting surface under the module should be flat to within +/- 0.05 mm (+/- 0.002 inch).

The module should be mounted to the heatsink using 3 mm (or 6-32) or equivalent screws torqued to 5-6 kg-cm (4-6 in-lb).

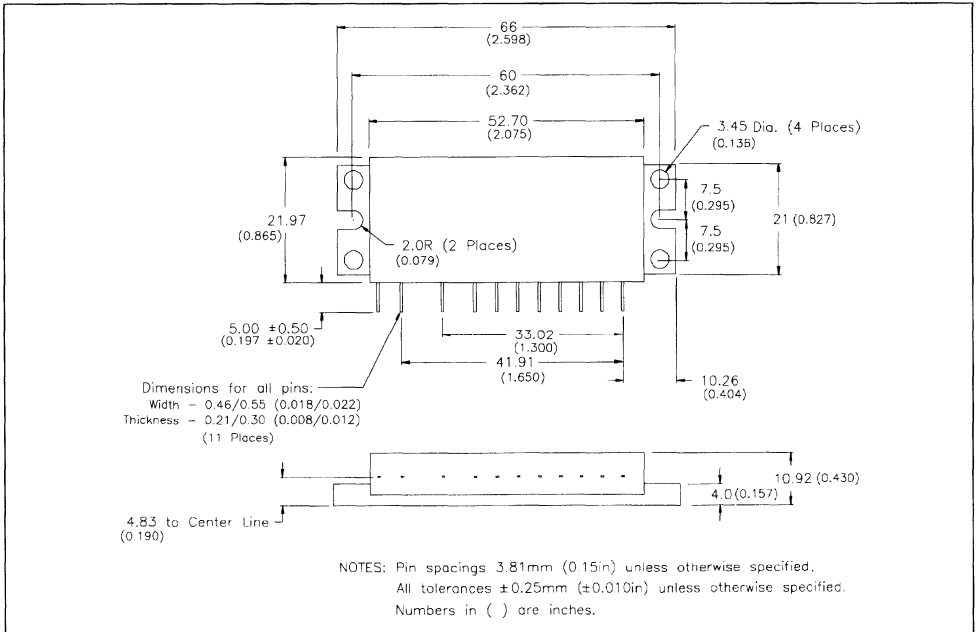
The module leads are attached to the PC board using 180°C solder. When soldering the leads to the application circuit, care must be taken to avoid time or temperature which may result in reflow of the lead connection inside the module.

**THERMAL CONSIDERATIONS**

It will be necessary to provide a suitable heatsink in order to maintain the module flange temperature at or below the maximum case operating temperature. In a case where the module output power will be limited to +45 dBm (32W PEP) and designing for the worst case double-tone efficiency of 25%, the power dissipated by the module will be 48 watts. The heatsink must be designed such that the thermal rise will be less than the difference between the maximum ambient temperature at which the module will operate and the maximum operating case temperature of the module while dissipating 48 watts.

At  $T_{case} = +70^{\circ}C$ ,  $V = 26v$ ,  $I_{Q1} = 0.1A$ ,  $I_{Q2} = 0.18A$ ,  $I_{Q3} = 0.18A$ ,  $I_{Q4} = 0.2A$ ,  $Z_L = 50$  ohms and  $P_{OUT} = +45dBm$  PEP, maximum junction temperatures for the individual transistors should be below the following values:  
 Q1 - 85°C, Q2 - 110°C, Q3 - 120°C and Q4 - 120°C.

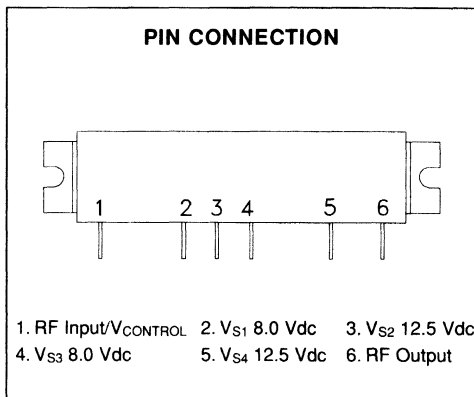
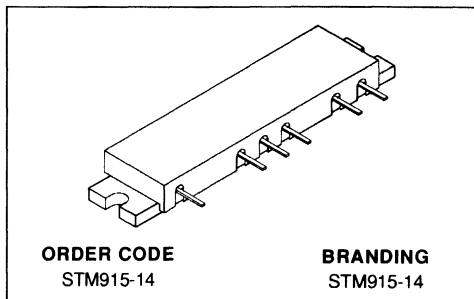
**PACKAGE MECHANICAL DATA**



**RF POWER MODULE  
 GSM MOBILE APPLICATIONS**

PRELIMINARY DATA

- LINEAR POWER AMPLIFIER
- 890 - 915 MHz
- 12.5 VOLTS
- INPUT/OUTPUT 50 OHMS
- $P_{OUT} = 14$  W MIN.
- GAIN = 41.5 dB MIN.


**DESCRIPTION**

The STM915-14 is a linear power module designed for 12.5 V applications in GSM Cellular Radio Systems. The STM915-14 uses gold metallized transistors with diffused emitter ballast resistors for high linearity Class AB operation

**ABSOLUTE MAXIMUM RATINGS** ( $T_{Case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{S2}, V_{S4}$	DC Supply Voltage (RF applied/No RF applied)	15.6/30.0	Vdc
$V_{S1}, V_{S3}$	DC Supply Voltage	8.5	Vdc
$V_{CONTROL}$	DC Control Voltage	4.5	Vdc
$P_{IN}$	RF Input Power ( $P_{OUT} \leq 15W$ )	3.0	mW
$P_{OUT}$	RF Output Power ( $V_{S2}, V_{S4} = 12.5V$ )	15	W
$T_{STG}$	Storage Temperature	- 30 to +100	$^{\circ}C$
$T_C$	Operating Case Temperature	- 30 to +100	$^{\circ}C$

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ ,  $V_{S1}, V_{S3} = 8.0$  Vdc;  $V_{S2}, V_{S4} = 12.5$  Vdc)

Symbol	Parameter	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
BW	Frequency Range		890	—	915	MHz
$P_{IN}$	Input Power	$V_{CONT} = 4.0$ Vdc $P_{OUT} = +41.5$ dBm	—	—	0	dBm
$\eta$	Efficiency <sup>1,2</sup>	$P_{OUT} = +41.5$ dBm	35	40	—	%
$I_{Q1}$	Quiescent Current, $V_{S1} V_{S2}$	$V_{CONT} = 0$ Vdc $P_{IN} = 1$ mW	—	0.5	2.0	mA
$I_{Q2}$	Quiescent Current, $V_{S3}$	$V_{CONT} = 0$ Vdc $P_{IN} = 1$ mW	—	120	130	mA
$I_{Q3}$	Quiescent Current, $V_{S4}$	$V_{CONT} = 0$ Vdc $P_{IN} = 1$ mW	—	200	250	mA
—	Control Dynamic Range	$V_{CONT} = 0$ to 4.0V	—	80	—	dB
H	Harmonics <sup>1,2</sup>	$P_{OUT} = +41.5$ dBm reference	—	-45	-40	dBc
$Z_{IN}$	Input Impedance <sup>1</sup>	$P_{OUT} = +13$ dBm to +41.5dBm	—	2.0	—	VSWR
$V_{CONT}$	Control Voltage		0	—	4.0	Vdc
$I_{CONT}$	Control Current		—	0.1	0.5	mA
$t_R$	Rise Time <sup>1,2</sup>	$P_{OUT} = +13$ to +41.5dBm	—	1.0	—	$\mu$ Sec
—	Noise Power <sup>1,2</sup>	30KHz Bandwidth, 20MHz above $f_0$ $P_{OUT} = +13$ dBm to +41.5dBm	—	-70	—	dBm
—	Stability <sup>1,2</sup>	$P_{OUT} = -36$ to +41.5dBm $V_{S2}, V_{S4} = 10.8$ to 15.6V Load VSWR = 6:1 Source VSWR = 3:1 $T_C = -20$ to +60°C	All Spurious outputs more than 60dB below carrier			
—	Load Mismatch	VSWR = 10:1 $V = 15.6$ Vdc $P_{OUT} = +41.5$ dBm	No Degradation in Output Power			

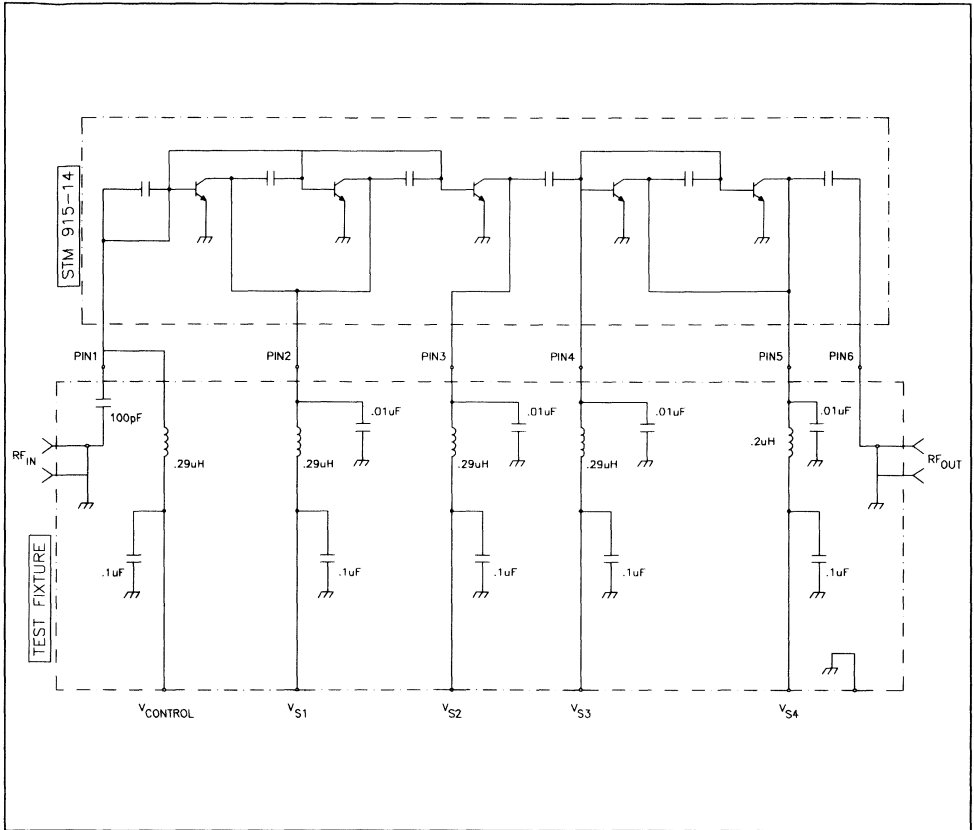
Notes: 1)  $P_{IN} = 1.0$ mW adjust  $V_{CONTROL}$  for specified  $P_{OUT}$ .

- 2) Pulse Width = 577  $\mu$ sec.  
Repetition rate = 4.6 msec.

**GSM SPECIFIC TESTS**

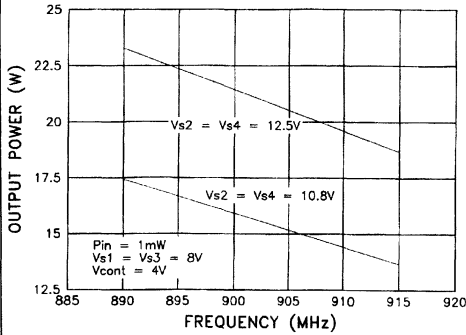
Symbol	Parameter	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
—	AM/AM Conversion Gain	$P_{IN} = f_0$ (0 dBm)+[ $f_0 + 200$ kHz (-40dBm)] $V_{CONTROL}$ adjusted for $P_{OUT} = 13, 30, 41.5$ dBm  $P_{OUT} (f_0 + 200$ kHz) $P_{OUT} (f_0 - 200$ kHz)		-41 -45		dBc
—	AM/PM Conversion	$P_{OUT} = +13$ to +41.5dBm $P_{IN}$ varied +/- 1.0dB		4		°/dB

## MODULE DC AND TEST FIXTURE CONFIGURATION

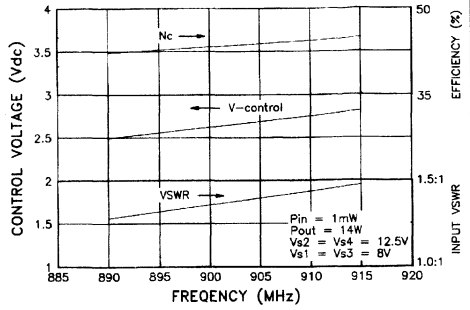


TYPICAL PERFORMANCE

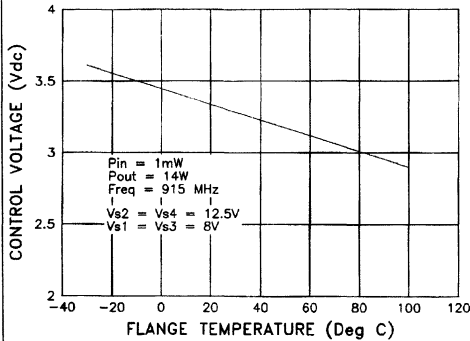
POWER OUTPUT vs FREQUENCY



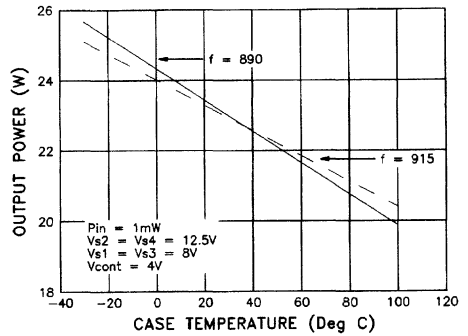
CONTROL VOLTAGE, EFFICIENCY & INPUT VSWR vs FREQUENCY



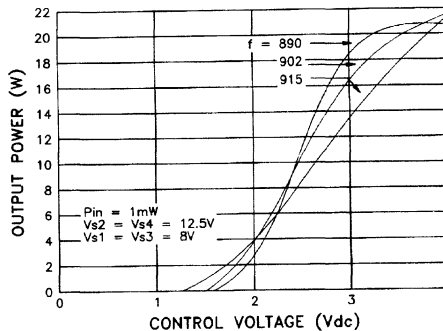
CONTROL VOLTAGE vs CASE TEMPERATURE



POWER OUTPUT vs CASE TEMPERATURE



POWER OUTPUT vs CONTROL VOLTAGE





**APPLICATIONS RECOMMENDATIONS**

**OPERATION LIMITS**

The STM915-14 power module should never be operated under any condition which exceeds the Absolute Maximum Ratings presented on this data sheet. Nor should the module be operated continuously at any of the specified maximum ratings. If the module is to be operated under any condition such that it may be subjected to one or more of the maximum rating conditions, care must be taken to monitor other parameters which may be affected. For example, a combination of high  $V_{S3}$  and input overdrive could result in exceeding the maximum output power rating; in this condition, the output power must be maintained below the maximum rating by use of the gain control pin.

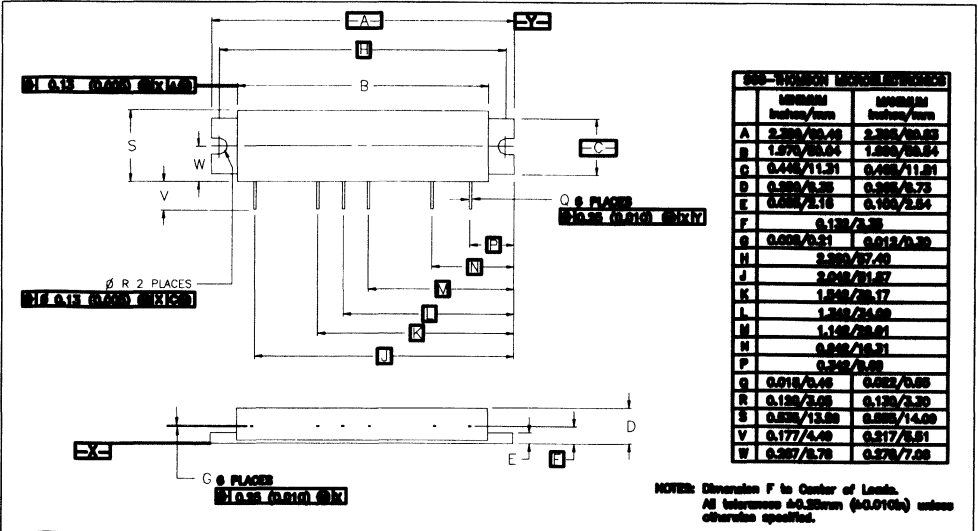
**GAIN CONTROL**

The module output power should be limited to 15 watts (41.76 dBm). The module is designed to be operated with  $V_{S1}$  and  $V_{S3}$  set to 8.0 Vdc,  $V_{S2}$  and  $V_{S4}$  set to 12.5 Vdc and input power set to 1.0 mW (0 dBm). Module gain is adjusted by varying  $V_{CONTROL}$ .

**DECOUPLING**

The bypassing internal to the module is sufficient for the frequency range 90 - 1300 MHz. Care should be taken to insure proper decoupling for each application as the module is capable of a wide range of operating characteristics including "linear" operation, in which an important design criteria is the use of appropriate bypassing. For bypassing low frequencies while maintaining the electrical specifications contained in this data sheet, use of the decoupling network shown in the "Module DC and Test Fixture Configuration" diagram herein is recommended.

**PACKAGE MECHANICAL DATA**



**MODULE MOUNTING**

To insure adequate thermal transfer from the module to the heatsink, it is recommended that a satisfactory thermal compound such as Dow Corning 340, Wakefield 120-2 or equivalent be applied between the module flange and the heatsink.

The heatsink mounting surface under the module should be flat to within +/- 0.05 mm (+/- 0.002 inch). The module should be mounted to the heatsink using 3 mm (or 4-40) or equivalent screws torqued to 5-6 kg-cm (4-6 in-lb).

The module leads are attached to the PC board using 180°C solder. When soldering the leads to the application circuit, care must be taken to avoid time or temperature which may result in re-flow of the lead connection inside the module.

**THERMAL CONSIDERATIONS**

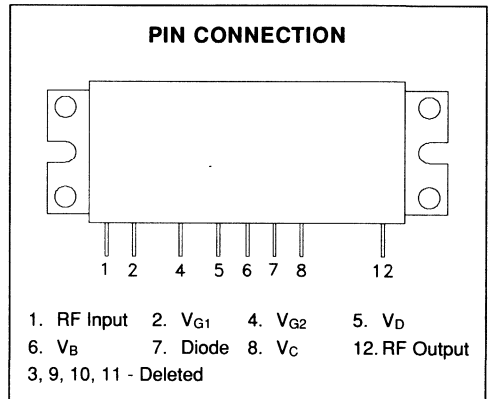
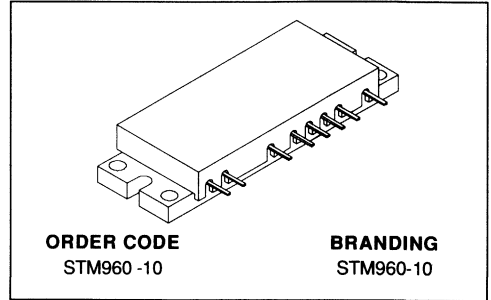
It will be necessary to provide a suitable heatsink in order to maintain the module flange temperature at or below the maximum case operating temperature. In a case where the module output power will be limited to +41.5 dBm (14 W) and designing for the worst case efficiency of 35%, the power dissipated by the module will be 26 watts. The heatsink must be designed such that the thermal rise will be less than the difference between the maximum ambient temperature at which the module will operate and the maximum operating case temperature of the module while dissipating 26 watts.



## RF POWER MODULE DIGITAL CELLULAR APPLICATIONS

PRELIMINARY DATA

- LINEAR POWER AMPLIFIER
- 915 - 960 MHz
- 26 VOLTS
- INPUT/OUTPUT 50 OHMS
- $P_{OUT} = 10$  W CW or PEP
- GAIN = 26 dB MIN.



### DESCRIPTION

The STM960-10 module is designed for digital cellular radio base station applications in the 915-960 MHz frequency range operating at 26V. The STM960-10 is designed to meet the low distortion, high linearity requirements of modern digital cellular base station equipment.

### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
V, V <sub>C</sub> , V <sub>D</sub>	DC Supply Voltage	28	V <sub>dC</sub>
I <sub>Q1</sub>	Bias Current @ V = 26V, 1st Stage	0.40	A <sub>dC</sub>
I <sub>Q2</sub>	Bias Current @ V = 26V, 2nd Stage	0.40	A <sub>dC</sub>
I <sub>Q3</sub>	Bias Current @ V = 26V, 3rd Stage	0.54	A <sub>dC</sub>
P <sub>IN</sub>	RF Input Power (P <sub>OUT</sub> ≤ 41.8 dBm CW)	15.8	dBm
P <sub>OUT, CW</sub>	RF Output Power (V = 26V)	41.8	dBm
P <sub>OUT, PEP</sub>	RF Output Power (V = 26V)	44.8	dBm
T <sub>STG</sub>	Storage Temperature	- 30 to +100	°C

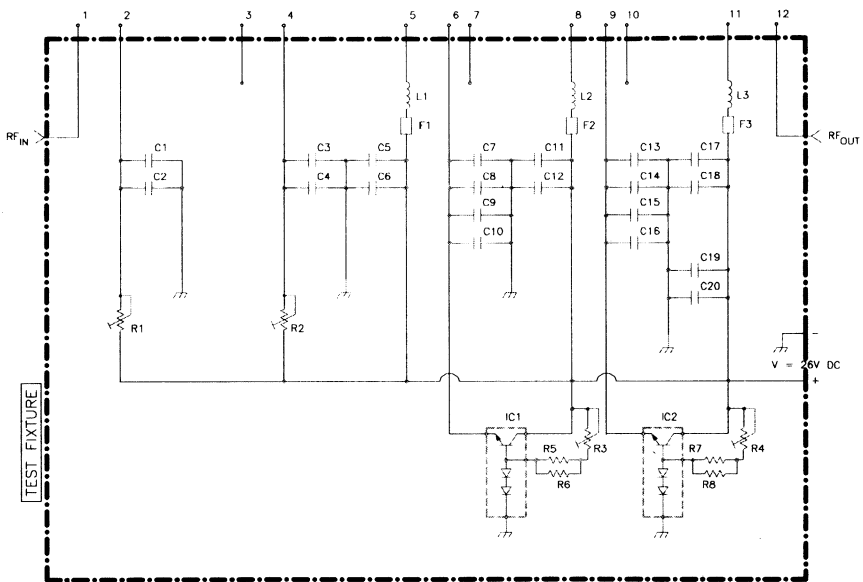
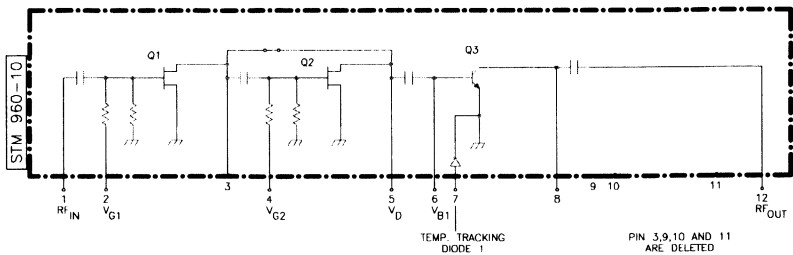
**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ ,  $V_D, V_C = 26V$ )  
 ( $IDQ1 = 100mA$ ,  $IDQ2 = 50mA$ ,  $ICQ = 50mA$ )

Symbol	Parameter	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
BW	Frequency Range		915	—	960	MHz
G <sub>P</sub>	Power Gain	P <sub>OUT</sub> = 40 dBm CW	26	28	—	dB
IMD*	Intermodulation Distortion	P <sub>OUT</sub> = 40 dBm PEP	—	-34	—	dB <sup>T</sup> **
η	Efficiency	P <sub>OUT</sub> = 40 dBm CW	30	35	—	%
Z <sub>IN</sub>	Input Impedance	P <sub>OUT</sub> = 40 dBm CW      Z <sub>S</sub> , Z <sub>L</sub> = 50Ω	—	1.5	2.0	VSWR
—	Power Degradation	P <sub>OUT</sub> = 40 dBm CW      T <sub>C</sub> = 0°C to 70°C	—	—	1.7	dB
—	Load Mismatch	VSWR = 5:1      V = 26Vdc P <sub>OUT</sub> = 40 dBm CW	No Degradation in Output Power			

Notes: \*Two-Tone Test Signal, 20kHz Separation.

 \*\*dB<sup>T</sup> - in dB, referenced to tone level

MODULE DC AND TEST FIXTURE CONFIGURATION



- C1, C3, C5, C7, C11, C13, C17 : 100 pF
- C2, C4, C6, C8, C12, C14, C18 : .001 μF
- C9, C15, C19 : .1 μF
- C10, C16, C20 : 100 μF
- F1, F2, F3 : FAIR-RITE #2664000101
- IC1, IC2 : TCCABB

L1, L2, L3 : 5 Turns of 24 AWG Wire, Inner Diameter 1.27mm

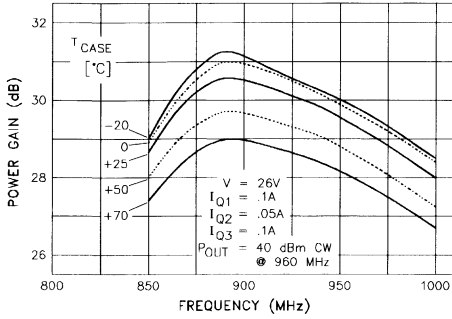
- R1, R2, R3, R4 : 5 KOHM
- R5, R6, R7, R8 : 1 KOHM

Setting Bias: (Ex. I<sub>Q1</sub> = 100mA, I<sub>Q2</sub> = 50mA, I<sub>Q3</sub> = 50mA)

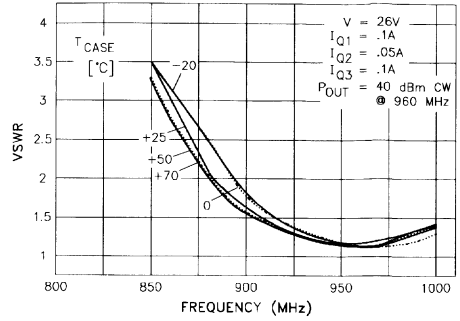
1. Set all variable resistors clockwise. (No bias current flows through transistors when all variable resistors are set clockwise.)
2. Record residual current I<sub>o</sub>. (mA)
3. Adjust R1 for (I<sub>o</sub> + 100)mA.
4. Adjust R2 for (I<sub>o</sub> + 100 + 50)mA.
5. Adjust R3 for (I<sub>o</sub> + 100 + 50 + 50)mA.

TYPICAL PERFORMANCE

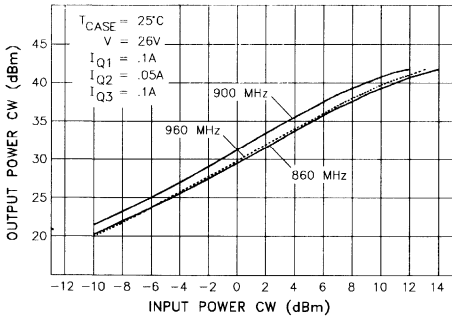
POWER GAIN vs FREQUENCY & TEMPERATURE



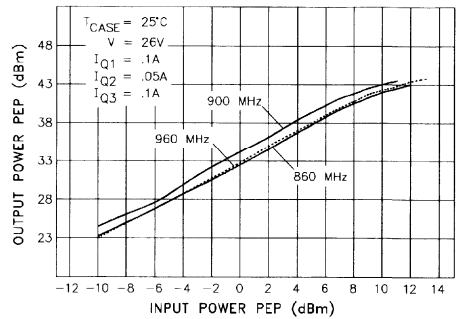
VSWR vs FREQUENCY & TEMPERATURE



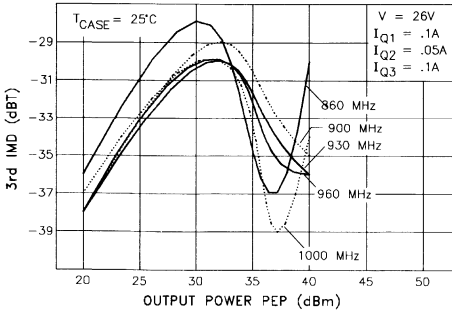
POWER OUTPUT vs POWER INPUT, CW



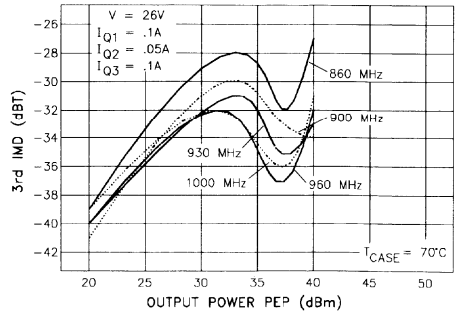
POWER OUTPUT vs POWER INPUT, PEP



3rd IMD vs POWER OUTPUT & TEMPERATURE

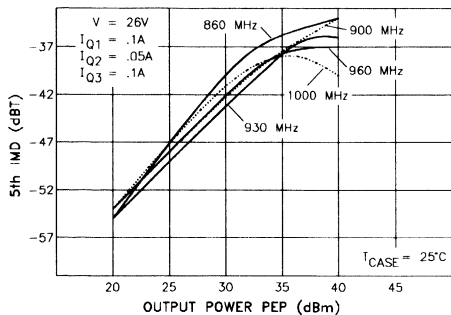


3rd IMD vs POWER OUTPUT & TEMPERATURE

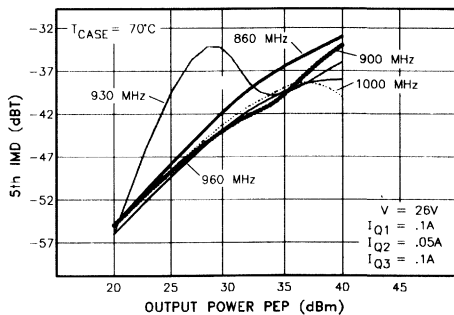


TYPICAL PERFORMANCE

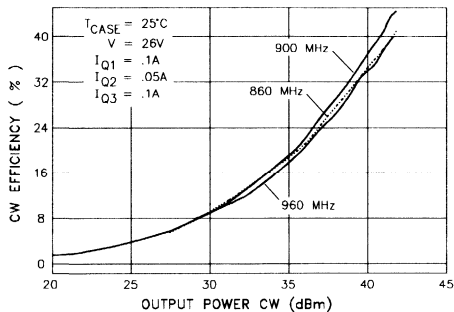
5th IMD vs POWER OUTPUT & TEMPERATURE



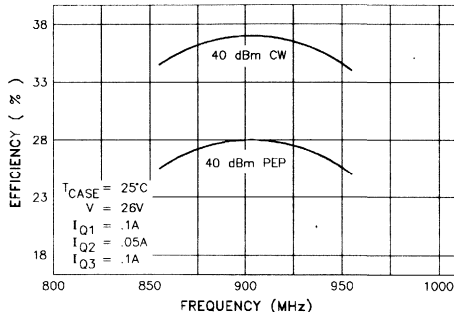
5th IMD vs POWER OUTPUT & TEMPERATURE



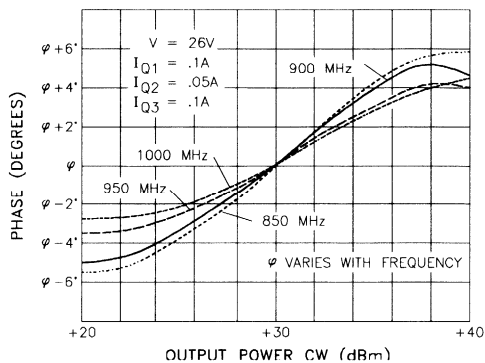
CW EFFICIENCY vs POWER OUTPUT



EFFICIENCY vs FREQUENCY



PHASE THROUGH MODULE vs POWER OUTPUT



**APPLICATIONS RECOMMENDATIONS**

**OPERATION LIMITS**

The STM960-10 power module should never be operated under any condition which exceeds the Absolute Maximum Ratings presented on this data sheet. Nor should the module be operated continuously at any of the specified maximum ratings. If the module is to be operated under any condition such that it may be subjected to one or more of the maximum rating conditions, care must be taken to monitor other parameters which may be affected.

**DECOUPLING**

Failure to properly decouple any of the voltage supply pins will result in oscillations at certain operating frequencies. Therefore, it is recommended that these pins be bypassed as indicated in the Module DC and Test Fixture Configuration drawing of this data sheet.

**MODULE MOUNTING**

To insure adequate thermal transfer from the module to the heatsink, it is recommended that a satisfactory thermal compound such as Wakefield 120-2 or equivalent be applied between the module flange and the heatsink.

The heatsink mounting surface under the module should be flat to within +/- 0.05 mm (+/- 0.002 inch). The module should be mounted to the heatsink using 6-32 or equivalent screws torqued to 5-6 kg-cm (4-6 in-lb).

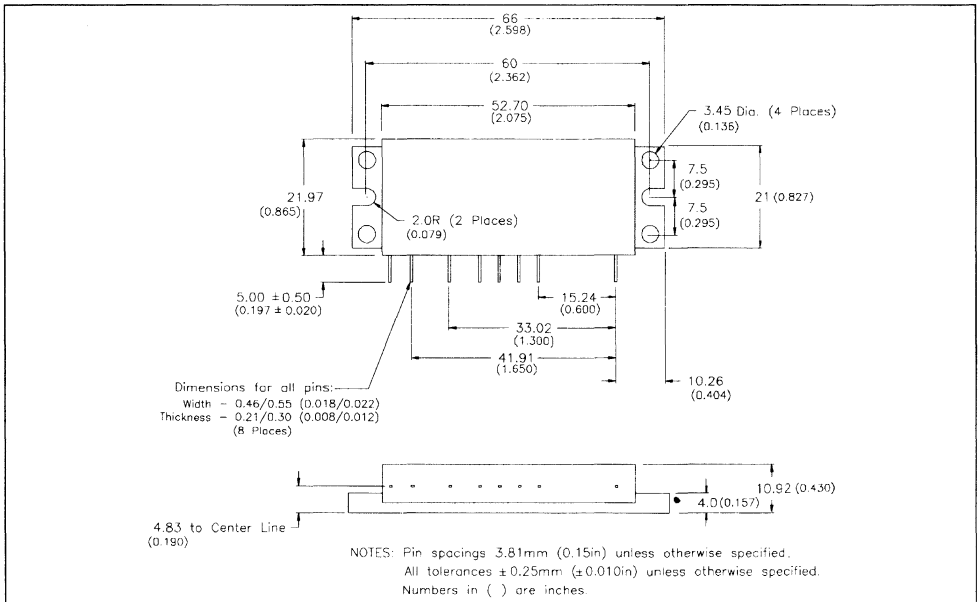
The module leads are attached to the PC board using 180°C solder. When soldering the leads to the application circuit, care must be taken to avoid time or temperature which may result in re-flow of the lead connection inside the module.

**THERMAL CONSIDERATIONS**

A suitable heatsink should be provided in order to maintain the module flange temperature at or below the maximum case operating temperature. If the module output power is +40dBm (10W), the power dissipated by the module will be 23.3 watts, assuming worst case efficiency of 30%. The heatsink must be designed so as to ensure that the thermal rise will be less than the difference between the maximum ambient temperature at which the module will operate and the maximum operating case temperature of the module while dissipating 23.3 watts.

At  $T_{case} = +70\text{ }^{\circ}\text{C}$ ,  $V = 26\text{V}$ ,  $I_{Q1} = 0.1\text{A}$ ,  $I_{Q2} = 0.05\text{A}$ ,  $I_{Q3} = 0.1\text{A}$ ,  $Z_L = 50\text{ ohms}$  and  $P_{OUT} = 10\text{W}$  CW, maximum junction temperatures for the individual transistors should be below the following values: Q1 - 110°C, Q2 - 115°C, and Q3 - 140°C.

**PACKAGE MECHANICAL DATA**

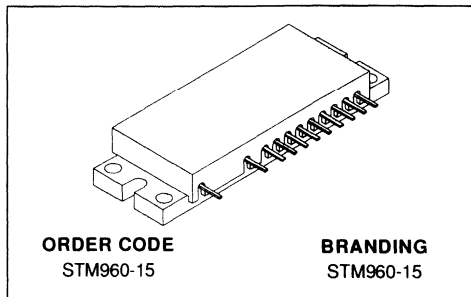




## RF POWER MODULE DIGITAL CELLULAR APPLICATIONS

PRELIMINARY DATA

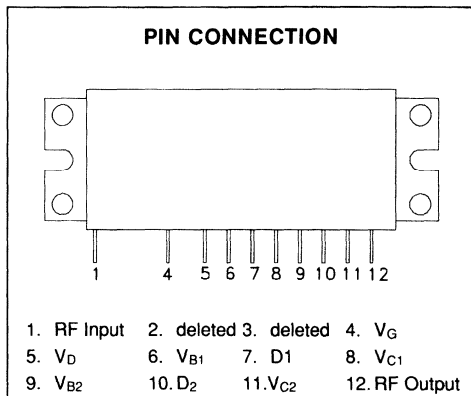
- LINEAR POWER AMPLIFIER
- 915 - 960 MHz
- 26 VOLTS
- INPUT/OUTPUT 50 OHMS
- $P_{OUT} = 42$  dBm CW or PEP
- GAIN = 26 dB TYP.



### DESCRIPTION

The STM960-15 module is designed for digital cellular radio base station applications in the 915-960 MHz frequency range operating at 26V.

The STM960-15 is designed to meet the low distortion, high linearity requirements of modern digital cellular base station equipment.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

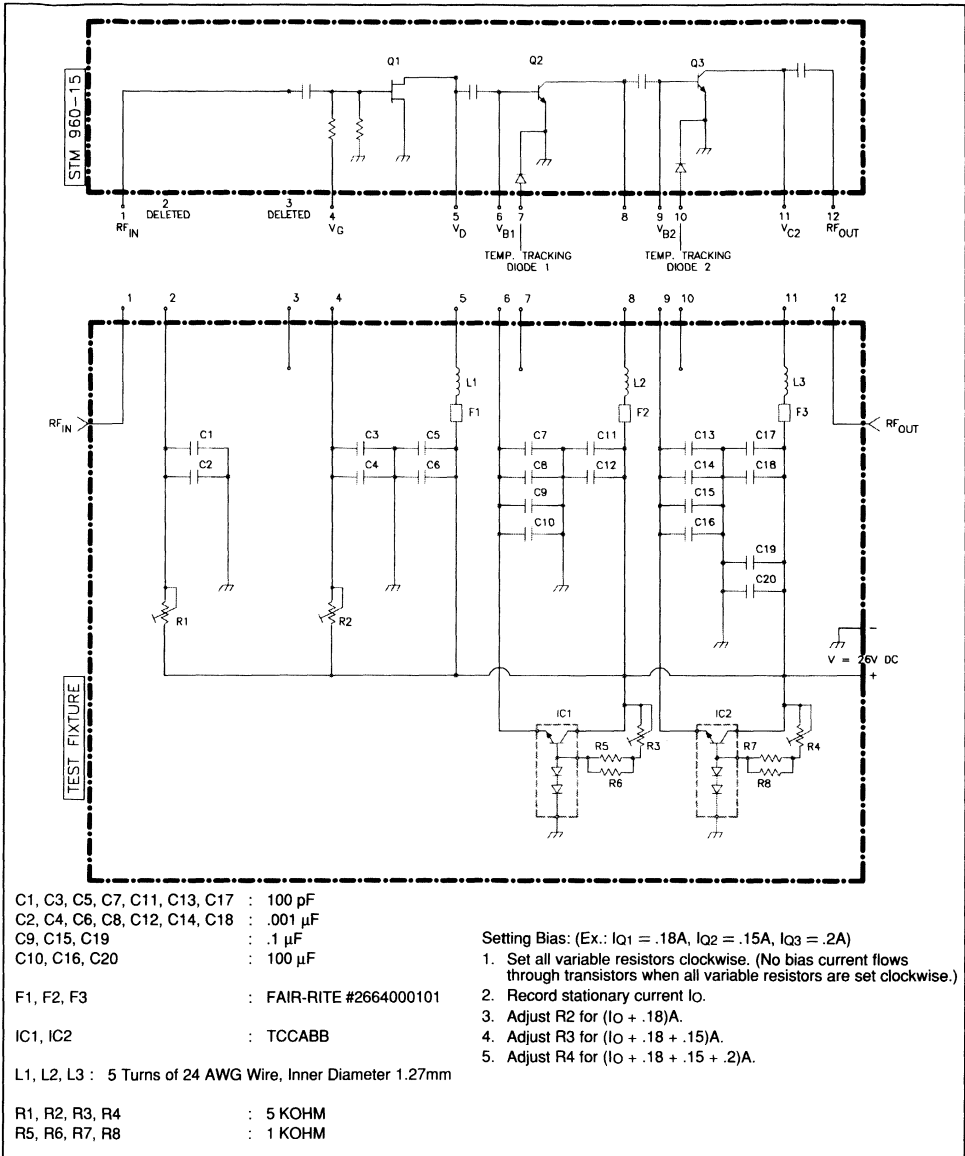
Symbol	Parameter	Value	Unit
$V, V_D, V_{C1}, V_{C2}$	DC Supply Voltage	28	Vdc
$I_{Q1}$	Bias Current @ V = 26V, 1st Stage	0.40	Adc
$I_{Q2}$	Bias Current @ V = 26V, 2nd Stage	0.54	Adc
$I_{Q3}$	Bias Current @ V = 26V, 3rd Stage	1.08	Adc
$P_{IN}$	RF Input Power ( $P_{OUT} < 42$ dBm CW)	22	dBm CW
$P_{OUT}$	RF Output Power (V = 26V)	44	dBm CW
$T_{STG}$	Storage Temperature	- 30 to +100	°C

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ ,  $V_D, V_{C1}, V_{C2} = 26V$ )  
 ( $I_{DQ1} = 180mA$ ,  $I_{CQ2} = 150mA$ ,  $I_{CQ3} = 200mA$ )

Symbol	Parameter	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
BW	Frequency Range		915	—	960	MHz
$G_P$	Power Gain	$P_{OUT} = +42$ dBm CW	22	26	—	dB
$\eta$	Efficiency	$P_{OUT} = +42$ dBm CW	31	36	—	%
$Z_{IN}$	Input Impedance	$P_{OUT} = +42$ dBm CW $Z_S, Z_L = 50\Omega$	—	1.5	2.0	VSWR
IMD*	Intermodulation Distortion	$P_{OUT} = +42$ dBm PEP	—	-34	-30	dBT**
—	Power Degradation	$P_{OUT} = +42$ dBm CW $T_C = 0^{\circ}C$ to $70^{\circ}C$	—	TBD	—	—
—	Load Mismatch	VSWR = 5:1 $V = 26Vdc$ $P_{OUT} = +42$ dBm CW	No Degradation in Output Power			

Note: \* Two-Tone test; 20 KHz separation \*\* dBT - in dB, referenced to tone level

## MODULE DC AND TEST FIXTURE CONFIGURATION



**APPLICATIONS RECOMMENDATIONS**

**OPERATION LIMITS**

The STM960-15 power module should never be operated under any condition which exceeds the Absolute Maximum Ratings presented on this data sheet. Nor should the module be operated continuously at any of the specified maximum ratings. If the module is to be operated under any condition such that it may be subjected to one or more of the maximum rating conditions, care must be taken to monitor other parameters which may be affected.

**DECOUPLING**

Failure to properly decouple any of the voltage supply pins will result in oscillations at certain operating frequencies. Therefore, it is recommended that these pins be bypassed as indicated in the Module DC and Test Fixture Configuration drawing of this data sheet.

**MODULE MOUNTING**

To insure adequate thermal transfer from the module to the heatsink, it is recommended that a satisfactory thermal compound such as Dow Corning 340, Wakefield 120-2 or equivalent be applied between the module flange and the heatsink.

The heatsink mounting surface under the module should be flat to within +/- 0.05 mm (+/- 0.002 inch).

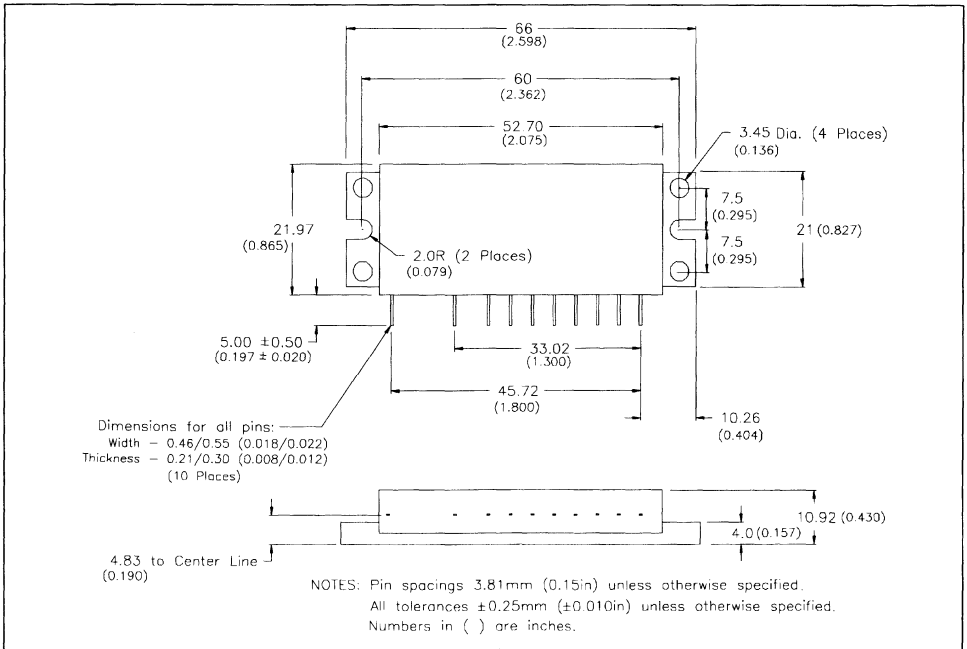
The module should be mounted to the heatsink using 3 mm (or 6-32) or equivalent screws torqued to 5-6 kg-cm (4-6 in-lb).

The module leads are attached to the PC board using 180°C solder. When soldering the leads to the application circuit, care must be taken to avoid time or temperature which may result in re-flow of the lead connection inside the module.

**THERMAL CONSIDERATIONS**

It will be necessary to provide a suitable heatsink in order to maintain the module flange temperature at or below the maximum case operating temperature. In a case where the module output power will be limited to +42 dBm (15.8W CW) and designing for the worst case double-tone efficiency of 31%, the power dissipated by the module will be 35 watts. The heatsink must be designed such that the thermal rise will be less than the difference between the maximum ambient temperature at which the module will operate and the maximum operating case temperature of the module while dissipating 35 watts.

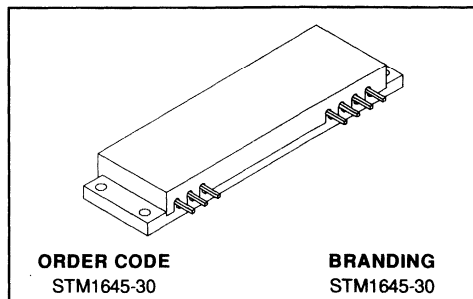
**PACKAGE MECHANICAL DATA**



## RF POWER MODULE SATELLITE COMMUNICATIONS APPLICATIONS

ADVANCED PRODUCT INFORMATION

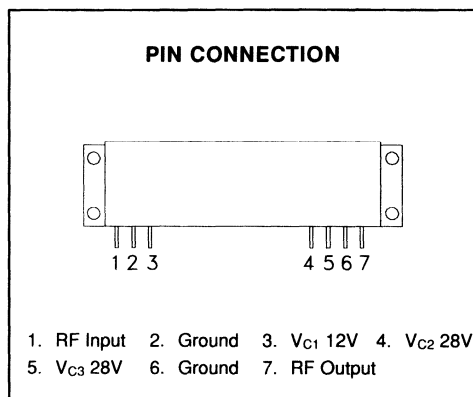
- CLASS C SATELLITE COMMUNICATIONS AMPLIFIER
- 1625 - 1665 MHz
- 28 VOLTS
- INPUT/OUTPUT 50 OHMS
- $P_{OUT} = 30 \text{ W MIN.}$
- $GAIN = 35 \text{ dB MIN.}$



### DESCRIPTION

The STM1645-30 hybrid RF power module is designed for high power satellite communications application in the 1.6 GHz frequency range.

High fr, gold metallized silicon microwave power devices, optimized for use in STM1645-30, are employed to provide high gain and efficiency while ensuring excellent reliability.



### ABSOLUTE MAXIMUM RATINGS ( $T_{case} = 25^{\circ}C$ )

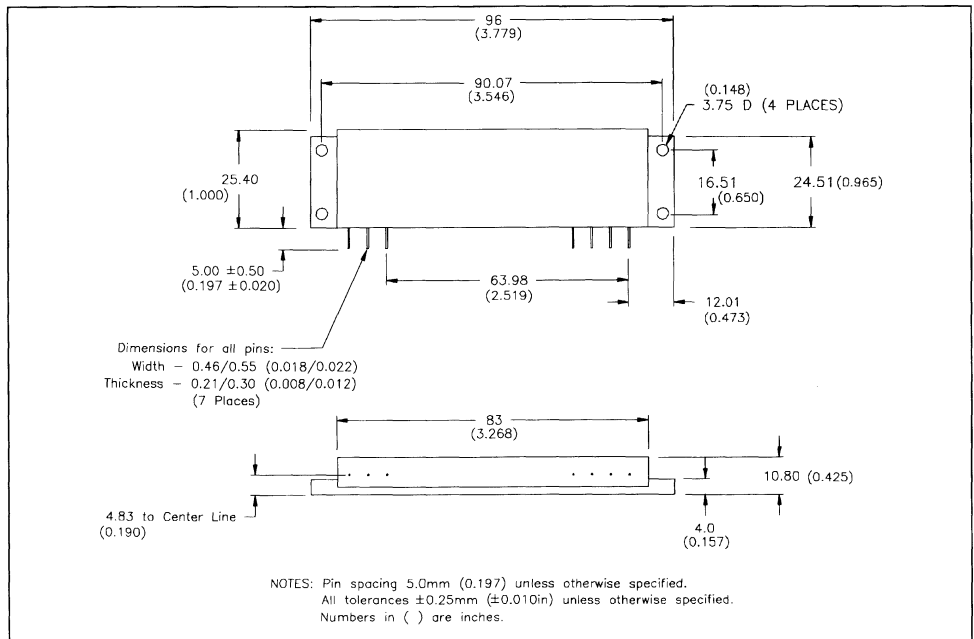
Symbol	Parameter	Value	Unit
V	DC Supply Voltage	30	Vdc
$P_{IN}$	RF Input Power ( $P_{OUT} \leq 30 \text{ W}$ )	20	mW
$T_{STG}$	Storage Temperature	- 40 to +100	$^{\circ}C$
$T_C$	Operating Case Temperature	- 35 to +70	$^{\circ}C$

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25\text{ }^{\circ}\text{C}$ ,  $V_{C1} = 12\text{ V}$ ,  $V_{C2}, V_{C3} = 28\text{ V}$ )

Symbol	Parameter	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
BW	Frequency Range		1625	—	1665	MHz
$P_{OUT}$	Power Output	$P_{IN} = \leq 10\text{ mW}$	30	35	40	W
$G_P$	Power Gain	$P_{OUT} = 30\text{ W}$	35	35.5	—	dB
$\eta$	Efficiency	$P_{OUT} = 30\text{ W}$	40	—	—	%
$Z_{IN}$	Input Impedance	$P_{OUT} = 30\text{ W}$ $Z_G, Z_L = 50\Omega$	—	1.5:1	2:1	VSWR
H	Harmonics	$P_{OUT} = 30\text{ W}$ reference	—	-45	-40	dB
—	$\Delta P_{OUT}$ vs $T_{CASE}$	$T_C = -35\text{ }^{\circ}\text{C}$ to $+70\text{ }^{\circ}\text{C}$	—	—	2	dB
—	$\Delta P_{OUT}$ vs Frequency	$f = 1625 - 1665\text{ MHz}$	—	—	1	dB
—	Load Mismatch	VSWR = 10:1 $V = 28\text{ Vdc}$ $P_{OUT} = 30\text{ W}$	No Degradation in Output Power			
—	$P_{OUT}$ Control Range	$P_{OUT} = 30\text{ W}$	8	10	—	dB
—	Stability	$P_{OUT} = 5$ to $30\text{ W}^*$ $T_C = -35\text{ }^{\circ}\text{C}$ to $+70\text{ }^{\circ}\text{C}$ Load VSWR = 3:1, any phase	All Spurious outputs more than 60dB below carrier			

\*Note:  $P_{OUT}$  adjusted by varying  $V_{C3}$

**PACKAGE MECHANICAL DATA**





## NOTES





## NOTES



## NOTES





## EUROPE

### DENMARK

#### 2730 HERLEV

Herlev Torv, 4  
Tel. (45-44) 94.85.33  
Telex: 35411  
Telefax: (45-44) 948694

### FINLAND

#### LOHJA SF-08150

Ratakatu, 26  
Tel. (358-12) 155.11  
Telefax: (358-12) 155.66

### FRANCE

#### 94253 GENTILLY Cedex

7 - avenue Gallieni - BP. 93  
Tel.: (33-1) 47.40.75.75  
Telex: 632570 STMHQ  
Telefax: (33-1) 47.40.79.10

#### 67000 STRASBOURG

20, Place des Halles  
Tel. (33-88) 75.50.66  
Telefax: (33-88) 22.29.32

### GERMANY

#### 8011 GRASBRUNN

Bretionischer Ring 4  
Postfach 1122  
Tel.: (49-89) 460060  
Telefax: (49-89) 4605454  
Teletex: 897107=STDISTR

#### 1000 BERLIN 37

Clay Allee 323  
Tel. (49-30) 8017087-89  
Telefax: (49-30) 8015552

#### 6000 FRANKFURT

Gutleutstrasse 322  
Tel. (49-69) 237492-3  
Telefax: (49-69) 231957  
Teletex: 6997689=STVBF

#### 3000 HANNOVER 51

Rotenburger Strasse 28A  
Tel. (49-511) 615960-3  
Teletex: 5118418 CSFBEH  
Telefax: (49-511) 6151243

#### 8500 NÜRNBERG 20

Erlenstegenstrasse, 72  
Tel.: (49-911) 59893-0  
Telefax: (49-911) 5980701

#### 7000 STUTTGART 31

Mittlerer Pfad 2-4  
Tel. (49-711) 13968-0  
Telefax: (49-711) 8661427

### ITALY

#### 20090 ASSAGO (MI)

V.le Milanofiori - Strada 4 - Palazzo A/4/A  
Tel. (39-2) 89213.1 (10 linee)  
Telex: 330131 - 330141 SGSAGR  
Telefax: (39-2) 8250410

#### 40033 CASALECCHIO

#### DI RENO (BO)

Via R. Fucini, 12  
Tel. (39-51) 593029  
Telex: 512442  
Telefax: (39-51) 591305

#### 00161 ROMA

Via A. Torlonia, 15  
Tel. (39-6) 8443341  
Telex: 620653 SGSATE I  
Telefax: (39-6) 8444474

### NETHERLANDS

#### 5652 AR EINDHOVEN

Meerenakkerweg 1  
Tel.: (31-40) 550015  
Telex: 51186  
Telefax: (31-40) 528835

### SPAIN

#### 08021 BARCELONA

Calle Platon, 6 4<sup>th</sup> Floor, 5<sup>th</sup> Door  
Tel. (34-3) 4143300-4143361  
Telefax: (34-3) 2021461

#### 28027 MADRID

Calle Albacete, 5  
Tel. (34-1) 4051615  
Telex: 46033 TCCEE  
Telefax: (34-1) 4031134

### SWEDEN

#### S-16421 KISTA

Borgarfjordsgatan, 13 - Box 1094  
Tel.: (46-8) 7939220  
Telex: 12078 THSWS  
Telefax: (46-8) 7504950

### SWITZERLAND

#### 1218 GRAND-SACONNEX

#### (GENEVA)

Chemin Francois-Lehmann, 18/A  
Tel. (41-22) 7986462  
Telex: 415493 STM CH  
Telefax: (41-22) 7984869

### UNITED KINGDOM and IRE

#### MARLOW, BUCKS

Planer House, Parkway  
Globe Park  
Tel.: (44-628) 890800  
Telex: 847458  
Telefax: (44-628) 890391

## AMERICAS

### BRAZIL

#### 05413 SÃO PAULO

R. Henrique Schaumann 286-  
CJ33  
Tel. (55-11) 883-5455  
Telex: (391)11-37988 "UMBR BR"  
Telefax: (55-11) 282-2367

### CANADA

#### NEPEAN ONTARIO K2H 9C4

301 Moodie Drive  
Suite 307  
Tel. (613) 829-9944

### U.S.A.

#### Montgomeryville PA 18936-1002

16 Commerce Drive  
Tel. (215) 361-6400  
Telefax (215) 362-1293

FOR OTHER SEMICONDUCTOR  
PRODUCTS CONTACT ONE OF  
THE FOLLOWING REGIONAL  
OFFICES IN THE U.S.A.

### ALABAMA

Huntsville - (205) 533-5995

### ARIZONA

Phoenix - (602) 867-6217

### CALIFORNIA

Santa Ana - (714) 957-6018  
San Jose - (408) 452-8585

### COLORADO

Boulder (303) 449-9000

### ILLINOIS

Schaumburg - (708) 517-1890

### INDIANA

Kokomo - (317) 455-3500

### MASSACHUSETTS

Lincoln - (617) 259-0300

### MICHIGAN

Livonia - (313) 953-1700

### NEW JERSEY

Voorhees - (609) 772-6222

### NEW YORK

Poughkeepsie - (914) 454-8813

### NORTH CAROLINA

Raleigh - (919) 787-6555

### TEXAS

Carrollton - (214) 466-8844

## ASIA / PACIFIC

### AUSTRALIA

#### NSW 2220 HURTSVILLE

Suite 3, Level 7, Otis House  
43 Bridge Street  
Tel. (61-2) 5803811  
Telefax: (61-2) 5806440

### HONG KONG

#### WANCHAI

22nd Floor - Hopewell centre  
183 Queen's Road East  
Tel. (852) 8615788  
Telex: 60955 ESGIES HX  
Telefax: (852) 8656589

### INDIA

#### NEW DELHI 110001

LiasonOffice  
62, Upper Ground Floor  
World Trade Centre  
Barakhamba Lane  
Tel. (91-11) 3715191  
Telex: 031-66816 STMI IN  
Telefax: (91-11) 3715192

### MALAYSIA

#### PETALING JAYA, 47400

11C, Jalan SS21/60  
Damansara Utama  
Tel.: (03) 717 3976  
Telefax: (03) 719 9512

#### PULAU PINANG 10400

4th Floor - Suite 4-03  
Bangunan FOP-123D Jalan  
Anson  
Tel. (04) 379735  
Telefax (04) 379816

### KOREA

#### SEOUL 121

8th Floor Shinwon Building  
823-14, Yuksam-Dong  
Kang-Nam-Gu  
Tel. (82-2) 553-0399  
Telex: SCSKOR K29998  
Telefax: (82-2) 552-1051

### SINGAPORE

#### SINGAPORE 2056

28 Ang Mo Kio - Industrial Park 2  
Tel. (65) 4821411  
Telex: RS 55201 ESGIES  
Telefax: (65) 4820240

### TAIWAN

#### TAIPEI

12th Floor  
325, Section 1 Tun Hua South  
Road  
Tel. (886-2) 755-4111  
Telex: 10310 ESGIE TW  
Telefax: (886-2) 755-4008

## JAPAN

#### TOKYO 108

Nisseki - Takanawa Bld. 4F  
2-18-10 Takanawa  
Minato-Ku  
Tel. (81-3) 3280-4121  
Telefax: (81-3) 3280-4131

Information furnished is believed to be accurate and reliable. However, SGS-THOMSON Microelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of SGS-THOMSON Microelectronics. Specification mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. SGS-THOMSON Microelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of SGS-THOMSON Microelectronics.

© 1993 SGS-THOMSON Microelectronics - Printed in Italy - All Rights Reserved  
Printed by Arti Grafiche Colombo - Gessate (MI) - Italy

SGS-THOMSON Microelectronics GROUP OF COMPANIES  
Australia - Brazil - France - Germany - Hong Kong - Italy - Japan - Korea - Malaysia - Malta - Morocco - The Netherlands -  
Singapore - Spain - Sweden - Switzerland - Taiwan - United Kingdom - U.S.A.